

# RF Power Bipolar Transistors

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Philips Semiconductors



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**DEFINITIONS**

<b>Data sheet status</b>	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
<b>Limiting values</b>	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	

## SELECTION GUIDE

## RF Power Bipolar Transistors

## Selection guide

## INTRODUCTION

The following tables represent our complete range of bipolar transmitting transistors, grouped according to main RF power application area. The data in each table is further grouped according to voltage and (within each voltage group) arranged in order of increasing power.

SSB class-AB;  $f = 28$  MHz;  $d_3$ ;  $d_5 < -30$  dB

$P_L$ (PEP) (W)	$V_{CE}$ (V)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
10	13.5	18	SOT48/2	BLY88A	1031
10	13.5	18	SOT120	BLY88C	1039
10	13.5	18	SOT123	BLV11	235
15	13.5	18	SOT56	BLY89A	1055
15	13.5	18	SOT120	BLY89C	1065
15	13.5	18	SOT123	BLW87	735
30	12.5	18	SOT56	BLW60	599
30	12.5	18	SOT120	BLW60C	613
30	12.5	18	SOT123	BLW85	709
80	12.5	12.5	SOT121	BLW99	807
10	28	20	SOT48/2	BLY92A	1097
10	28	20	SOT120	BLY92C	1105
10	28	20	SOT123	BLV21	257
25	28	18	SOT56	BLX13	813
25	28	18	SOT120	BLX13C	825
25	28	18	SOT123	BLW83	691
40	28	17	SOT120	BLX39	865
45	28	17	SOT123	BLW86	721
50	28	13	SOT55	BLX14	835
80	28	13	SOT121	BLW76	625
100	28	19	SOT121	BLW78	653
130	28	12	SOT121	BLW77	639
175	11.5	20	SOT121	BLW97	789
50	50	18	SOT123	BLW50F	589
150	50	14	SOT55	BLX15	849
160	50	14	SOT121	BLW95	767
200	50	13.5	SOT121	BLW96	777

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SSB class-A;  $f = 28$  MHz;  $d_3$ ;  $d_6 < -40$  dB

$P_L$ (PEP) (W)	$V_{CE}$ (V)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
1	12	18	SOT122	BLY87C/01	1023
1	12	18	SOT120	BLY87C	1015
1	12	18	SOT123	BLV10	227
2	12	18	SOT122	BLY88C/01	1047
2	12	18	SOT120	BLY88C	1039
2	12	18	SOT123	BLV11	235
6	12	18	SOT120	BLY89C	1065
6	12	18	SOT123	BLW87	735
1.3	26	20	SOT48/2	BLY91A	1081
1.3	26	20	SOT120	BLY91C	1089
1.3	26	20	SOT123	BLV20	249
2.5	26	20	SOT48/2	BLY92A	1097
2.5	26	20	SOT120	BLY92C	1105
2.5	26	20	SOT123	BLV21	257
8	26	18	SOT56	BLX13	813
8	26	20	SOT120	BLX13C	825
10	26	20	SOT123	BLW83	691
15	26	18	SOT120	BLX39	865
17	26	20	SOT123	BLW86	721
30	26	18	SOT121	BLW78	653
16	45	19.5	SOT123	BLW50F	589
50	40	19	SOT121	BLW96	777

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## VHF base stations; class-B operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
1	28	175	15	TO-39/1	2N3866	1153
4	28	175	10	TO-39/1	BFS23A	71
8	28	175	12	SOT48/2	BLY91A	1081
8	28	175	12	SOT120	BLY91C	1089
8	28	175	12	SOT123	BLV20	249
15	28	175	10	SOT48/2	BLY92A	1097
15	28	175	10	SOT120	BLY92C	1105
15	28	175	10	SOT123	BLV21	257
25	28	175	9	SOT56	BLY93A	1113
25	28	175	9	SOT120	BLY93C	1121
25	28	175	9	SOT123	BLW84	701
45	28	175	7.5	SOT120	BLX39	865
45	28	175	7.5	SOT123	BLW86	721
50	28	175	7	SOT55	BLY94	1129
80	28	175	6.5	SOT121	BLV80/28	395
80	28	108	8	SOT121	BLW76	625
100	28	150	6	SOT121	BLW78	653
130	28	87.5	7.5	SOT121	BLW77	639
250	28	108	10.5	SOT179	BLV37	341
150	50	108	7.5	SOT55	BLX15	849
160	50	108	7	SOT121	BLW95	767
200	50	108	6.5	SOT121	BLW96	777

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## VHF mobile transmitters; class-B operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
1	12	175	10	TO-39/1	2N4427	1153
2	13.5	175	11	TO-39/1	BFQ42	45
4	13.5	175	8	TO-39/1	BFS22A	63
4	13.5	175	12	TO-39/3	BFQ43	55
4	13.5	175	12	TO39/3	BFQ43S	55
8	13.5	175	9	SOT122	BLY87C/01	1023
8	13.5	175	12	SOT120	BLY87C	1015
8	13.5	175	9	SOT123	BLV10	227
15	13.5	175	10	SOT120	BLW29	537
15	13.5	175	7.5	SOT122	BLY88C/01	1047
15	13.5	175	8	SOT120	BLY88C	1039
15	13.5	175	7.5	SOT123	BLV11	235
25	13.5	175	6	SOT56	BLY89A	1055
25	13.5	175	6	SOT120	BLY89C	1065
25	13.5	175	6	SOT123	BLW87	735
28	13.5	175	9	SOT120	BLW31	551
30	12.5	175	9	SOT123	BLV12	243
30	12.5	175	11.5	SOT120	BLW30	545
45	12.5	175	6.5	SOT119	BLV45/12	353
45	12.5	175	5	SOT120	BLW60C	613
45	12.5	175	4.5	SOT123	BLW85	709
50	12.5	175	5	SOT55	BLY90	1073
75	12.5	175	6.5	SOT119	BLV75/12	385

## RF Power Bipolar Transistors

## Selection guide

## 470 MHz base stations; class-B operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
1	28	470	7	TO-39/1	2N3866	1153
1	28	470	11	SOT48/3	BLX91A	927
2	28	470	12	SOT122	BLW89	743
2.5	28	470	11	SOT48/3	BLX92A	941
4	28	470	11	SOT122	BLW90	751
7	28	470	8.5	SOT48/3	BLX93A	951
10	28	470	9	SOT122	BLW91	759
25	28	470	6	SOT48	BLX94A	961
25	28	470	6.5	SOT122	BLX94C	961
25	24	470	8	SOT119	BLU30/28	153
30	28	470	8	SOT119	BLU30/28	153
40	28	470	4.5	SOT56	BLX95	971
50	24	470	7	SOT119	BLU60/28	185
60	28	470	7	SOT119	BLU60/28	185

## UHF mobile transmitters; class-B operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
1.2	7.5	470	10.5	SOT223	BLT50	79
1	12.5	470	12	SOT223	BLU56	169
2	12.5	470	6	TO-39/1	BLX65	879
2	12.5	470	9	TO-39/3	BLX65E	891
2	12.5	470	9	SOT122	BLW79	667
2.5	12.5	470	10	SOT122D	BLU11/SL	123
4	12.5	470	8	SOT122	BLW80	675
5	12.5	470	10.5	SOT122	BLU99	215
7	12.5	470	8.5	SOT122	BLU97	199
10	12.5	470	6	SOT122	BLW81	683
15	12.5	470	7.8	SOT122	BLU15/12	129
20	12.5	470	6.5	SOT119	BLU20/12	137
20	13.5	470	4	SOT48/2	BLX69A	919
30	12.5	470	6	SOT119	BLU30/12	145
45	12.5	470	4.8	SOT119	BLU45/12	161
60	12.5	470	4.4	SOT119	BLU60/12	177



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## 900 MHz base stations; class-B operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
2	24	900	8	SOT172	BLV99	509
8	24	960	8	SOT171	BLV100	517
14	24	900	8.5	SOT171	BLV98	491
15	24	960	7.5	SOT171	BLV98CE	499
30	24	900	7	SOT171	BLV97	473
35	24	960	7	SOT171	BLV97CE	481
50	26	900	9.8	SOT273	BLV101A	527
50	26	960	8.1	SOT273	BLV101B	527

## 900 MHz mobile transmitters; class-B operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
0.75	7.5	900	7	SOT172D	BLT90/SL	91
0.8	7.5	900	6	SOT223	BLT80	85
1.5	7.5	900	6	SOT172D	BLT91/SL	99
3	7.5	900	7	SOT122D	BLT92/SL	107
6	7.5	900	5.5	SOT122D	BLT93/SL	115
1	12.5	900	7	SOT223	BLU86	193
1	12.5	900	7.5	SOT172	BLV90	405
1	12.5	900	7.5	SOT172D	BLV90/SL	413
2	12.5	900	6.5	SOT172	BLV91	421
2	12.5	900	6.5	SOT172D	BLV91/SL	429
0.5	12.5	900	8	SOT103	BLU98	207
4	12.5	900	7	SOT122	BLU99	215
4	12.5	900	7.5	SOT171	BLV92	437
8	12.5	900	6.5	SOT171	BLV93	445
15	12.5	900	6	SOT171	BLV94	455
22	12.5	900	5.5	SOT171	BLV95	465

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## FM broadcast transmitters; class-B operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	ENVELOPE	TYPE NUMBER	PAGE
1	28	87.5 to 108	18	TO-39/3	2N3866	1153
4	28	87.5 to 108	20	SOT122	BLW90	751
15	28	87.5 to 108	15	SOT123	BLV21	257
45	28	87.5 to 108	11	SOT120	BLX39	865
45	28	87.5 to 108	11	SOT123	BLW86	721
100	28	87.5 to 108	8	SOT121	BLW78	653
175	28	87.5 to 108	10.5	SOT119	BLV25	265
250	28	87.5 to 108	10.5	SOT179	BLV37	341

## TV transposer circuits; band III; class-A operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	$d_{im}$ (dB)	$I_c$ (mA)	ENVELOPE	TYPE NUMBER	PAGE
1.5	25	225	18	-60	460	SOT122	BLV30	273
5	25	225	15	-58	800	SOT122	BLV31	283
10	25	225	16	-55	1500	SOT160	BLV32F	293
16	25	225	13.5	-55	3200	SOT119	BLV33F	315
19	25	225	9	-55	3200	SOT147	BLV33	303

## TV transmitter circuits; band III; class-AB operation

$P_L$ (PEP) (W) (note 1)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	$d_{im}$ (dB)	$I_c$ (mA)	ENVELOPE	TYPE NUMBER	PAGE
85	28	225	10.5	-	4250	SOT119	BLV33F	315
90	28	225	6.5	-	4460	SOT147	BLV33	303
115	28	225	10	-	2 x 3750	SOT161	BLV36	329
225	35	225	8	-	2 x 6000	SOT179	BLV38	347

## Note

1. At 1 dB power gain compression.

## TV transposer circuits; band IV-V; class-A operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	$d_{im}$ (dB)	$I_c$ (mA)	ENVELOPE	TYPE NUMBER	PAGE
0.12	10	860	10	-60	70	SOT37	BFR96S	note 1
0.3	15	860	11	-60	120	SOT122	BFQ34	note 1
0.5	25	860	11	-60	150	SOT122	BLW32	559
0.7	15	860	10	-60	240	SOT122	BFQ68	note 1
1	25	860	10	-60	300	SOT122	BLW33	569
1.8	25	860	9	-60	600	SOT122	BLW34	579
3.5	25	860	6.5	-60	850	SOT122	BLW98	797
6	25	860	8	-60	2 x 850	SOT161	BLV57	361

## Note

1. See Handbook SC14, 'Wideband Transistors and Wideband Hybrid IC Modules'.

## TV transmitter circuits; band IV-V; class-AB operation

$P_L$ (PEP) (W)	$V_{CE}$ (V)	f (MHz)	$G_p$ (dB)	$d_{im}$ (dB)	$I_c$ (mA)	ENVELOPE	TYPE NUMBER	PAGE
30 (note 1)	25	860	7	-	2400	SOT171	BLV59	375

## Note

1. At 1 dB power gain compression.



**LINE-UPS**

## RF Power Bipolar Transistors

## Line-ups

## INTRODUCTION

In this section, we present information on recommended circuit line-ups in the main RF power application areas. A comprehensive range of output power levels is indicated, together with our recommended types in the particular line-up configuration. The necessary drive power level for each line-up is indicated in the first column.

More detailed application information can be found in the application reports book 'Bipolar and MOS Transmitting Transistors' (9398 074 40011).

## SSB transmitters (1.5 to 30 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	P <sub>L</sub> (PEP) (W)	V <sub>CE</sub> (V)	S = STUD F = FLANGE
30	BLY87C (note 1)	2 x BLY89C		30	13	S
30	BLV10 (note 1)	2 x BLW87		30	13	F
50	BLY88C (note 1)	2 x BLW60C		50	13	S
50	BLV11 (note 1)	2 x BLW85		50	13	F
100	BLY89C (note 1)	4 x BLW60C		100	13	S
100	BLY87 (note 1)	4 x BLW85		100	13	F
140	2 x BLW87 (note 1)	2 x BLW99		150	13	F
50	BLY91C (note 1)	2 x BLX13C		50	28	S
50	BLV20 (note 1)	2 x BLW83		50	28	F
150	BLW83 (note 1)	2 x BLW76		150	28	F
250	2 x BLW83 (note 1)	2 x BLW77		250	28	F
220	2 x BLW86 (note 1)	2 x BLW97		300	28	F
500	2 x BLW86	4 x BLW77		450	28	F
680	2 x BLW78 (note 1)	4 x BLW97		600	28	F
300	2 x BLX13C (note 2)	2 x BLX15		250	50	S
300	2 x BLW83 (note 2)	2 x BLW96		350	50	F
600	2 x BLX39 (note 2)	4 x BLX15		500	50	S
600	2 x BLW50F (note 1)	4 x BLW95		500	50	F
40	BLY91C (note 2)	2 x BLW78 (note 2)	8 x BLX15	1000	50	S/F
40	BLV20 (note 2)	4 x BLW50F	8 x BLW96	1200	50	F

## Notes

1. Class-A operation.
2. 28 V supply voltage in class-A operation.

## RF Power Bipolar Transistors

## Line-ups

## Mobile transmitters (68 to 87.5 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	$P_L$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
20	2N4427	BLY87C	8	13	S
20	2N4427	BLV10	8	13	F
35	2N4427	BLW29	14	13	S
10	BSX190	BLY32	18	13	F
70	BFQ42	BLW31	28	13	S
160	BFQ43	BLW60C	45	13	S
160	BFQ43	BLW85	45	13	F
190	BLV10	BLV75/12	75	13	F

## Base stations (68 to 87.5 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_L$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
65	BFS23A	BLY93C		25	28	S
65	BFS23A	BLW84		25	28	F
125	BLX92A	BLX39		50	28	S
15	2N3866	BLV21	BLW78	100	28	F
50	2N3866 (note 1)	BLY93C (note 1)	BLX15	150	50	S
50	2N3866 (note 1)	BLW84 (note 1)	BLW95	150	50	F

## Note

- 28 V supply voltage in class-A operation.

## FM broadcast transmitters (87.5 to 108 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_L$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
100	BLW90	BLX39		50	28	S
40	2N3866	BLV21	BLW78	100	28	F
100	BLW90	BLW86	2 x BLV25	300	28	F
500	BLV21	BLW78	2 x BLV37	500	28	F
600	BLV21	BLV25	4 x BLV37	1000	28	F

## RF Power Bipolar Transistors

Line-ups

## AM aircraft transmitters (118 to 136 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_{L(carr)}$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
110	BLX92C	BLY93C		6	13/28	S
240	BLY91C	BLX39		12	13/28	S
240	BLV20	BLW86		12	13/28	F
100	BLX92A	BLY93C	BLW78	25	13/28	S/F
100	BLX92A	BLW84	BLW78	25	13/28	S/F

## AM aircraft transmitters (100 to 400 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_{L(carr)}$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
40	BLX91C	2 x BLW90	2 x BLX94C	40	28	S
120	BLX91C	2 x BLX93A	2 x BLU30/28	60	28	S/F
500	BLW90	2 x BLX94C	2 x BLU60/28	120	28	S/F

## Portable and mobile transmitters (132 to 174 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_L$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
40	2N4427	BFQ43		2	7.5	-
100	2N4427	BLY87C		8	13	S
100	2N4427	BLV10		8	13	F
125	BFQ42	BLW29		14	13	S
150	BGY36			18	13	F
200	BFQ43	BLW30		30	12.5	S
200	BFQ43	BLV12		30	12.5	F
250	BFQ43	BLW31		28	13	S
100	2N4427	BLW29	BLV45/12	45	13	S/F
115	BGY43	BLV45/12		45	13	F
120	BFQ42	BLW29	BLV75/12	75	13	S/F



## RF Power Bipolar Transistors

Line-ups

## Base stations (132 to 174 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_L$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
200	BLY91C	BLY93C		25	28	S
200	BLV20	BLW84		25	28	F
25	2N3866	BLY91C	BLX39	50	28	S
25	2N3866	BLV20	BLW86	50	28	F
200	BFS23A	BLY93C	2 x BLX39	100	28	S
200	BFS23A	BLW84	2 x BLW86	100	28	F

## TV transposers (Band III: 174 to 230 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	4th STAGE	$P_{o \text{ sync}}$ (W)	$P_{o \text{ sat}}$ (W)	$V_{CE}$ (V)
7	BLV30	2 x BLV32F			20	20	25
6	BLV30	2 x BLV33F	4 x BLV33		60	75	25

## TV transmitters (Band III: 174 to 230 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_{o \text{ sync}}$ (W)	$V_{CE}$ (V)
10	BLV30	2 x BLV32F	2 x BLV38	225	25/28/35
35	BLV30	2 x BLV32F	4 x BLV38	420	25/28/35
75	2 x BLV30	4 x BLV33F	8 x BLV38	800	25/28/35

## RF Power Bipolar Transistors

## Line-ups

## Portable and mobile transmitters (400 to 512 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	P <sub>L</sub> (W)	V <sub>CE</sub> (V)	S = STUD F = FLANGE
15	BFR96 (note 1)	BLW79	BLW80	2	7.5	S
45	BLV90	BLU99		3	7.5	S
15	BFR96S (note 1)	BLU99	BLW81	10	13	S
250	BLU99	BLU15/12		15	12.5	S
400	BLU99	BLU20/12		20	–	S/F
280	BLU99	BLU20/12	BLU45/12	45	13	S/F
400	BLU99	BLU20/12	BLU60/12	60	13	S/F

## Base stations (400 to 470 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	P <sub>L</sub> (W)	V <sub>CE</sub> (V)	S = STUD F = FLANGE
40	BLX91A	BLW91	BLX94C	30	28	S
220	BLW90	BLX94C	BLU60/28	60	28	S/F
60	BLX91A	BLX93A	BLU30/28	30	28	S/F

## TV transposers (Band IV/V: 470 to 860 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	4th STAGE	P <sub>o sync</sub> (W)	P <sub>o sat</sub> (W)	V <sub>CE</sub> (V)
5	BFQ34 (note 1)	BFQ68 (note 1)	2 x BFQ68 (note 1)		1.4	1.4	15
6	BLW32	BLW33	2 x BLW34		4.4	5.7	25
2	BLW32	BLW33	2 x BLW34	2 x BLW98	8	8	25
3	BLW32	BLW33	2 x BLW34	2 x BLV57	13	15	25
10	BFQ68 (note 1)	2 x BLW34	2 x BLW98	4 x BLV57	23	30	25
14	BFQ68 (note 1)	2 x BLW34	2 x BLV57	8 x BLV57	38	60	25

## Note

1. See Handbook SC14 'Wideband Transistors and Wideband Hybrid IC Modules'.

## RF Power Bipolar Transistors

## Line-ups

## TV transmitters (Band IV/V: 470 to 860 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	4th STAGE	$P_{o\ sync}$ (W) (note 1)	$V_{CE}$ (V)
12	BFR96S (note 2)	BFQ68 (note 2)	2 x BLW34	2 x BLV59	60	28
30	BFQ34 (note 2)	2 x BLW33	2 x BLV57	4 x BLV59	120	28
80	BFQ68 (note 2)	2 x BLW34	4 x BLV57	8 x BLV59	240	28

## Notes

1. With linearity correction.
2. See Handbook SC14 'Wideband Transistors and Wideband Hybrid IC Modules'.

## Mobile transmitters (860 to 960 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	4th STAGE	$P_L$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
60	BLU98	BLV91	BLV93		8	13	S/F
100	BLV90	BLV92	BLV94		15	13	S/F
50	BLV98	BLV91	BLV93	BLV95	22	13	S/F

## Base stations (860 to 960 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_L$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
240	BLV99	BLV98CE	BLV101A/B	50	24	S/F
600	BLV100	BLV97CE	2 x BLV101A/B	100	24	F

## Portable transmitters (860 to 960 MHz)

INPUT POWER (mW)	1st STAGE	2nd STAGE	3rd STAGE	$P_L$ (W)	$V_{CE}$ (V)	S = STUD F = FLANGE
5	BFG90A	BFG96	BLT91/SL	1.5	7.5	-
15	BFG91A	BLT90/SL	BLT92/SL	3	7.5	-



**TYPE NUMBER SURVEY**

## RF Power Bipolar Transistors

## Type number survey

## INTRODUCTION

In this alphanumeric list we present all transmitting transistors mentioned in this handbook, together with the most important data.

TYPE	ENVELOPE	MODE OF OPERATION	V <sub>CE</sub> (V)	f (MHz)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	PAGE
BFQ42	TO-39/1	c.w. class-B	13.5	175	2	> 11	45
			12.5	175	2	typ. 10.5	
BFQ43	TO-39/3	c.w. class-B	13.5	175	4	> 12	55
			12.5	175	4	typ. 12	
BFQ43S	TO-39/3	c.w. class-B	13.5	175	4	> 12	55
			12.5	175	4	typ. 12	
BFS22A	TO-39/1	c.w. class-B	13.5	175	4	> 8	63
			12.5	175	4	typ. 8	
BFS23A	TO-39/1	c.w. class-B	28	175	4	> 10	71
BLT50	SOT223	c.w. class-B	7.5	470	1.2	> 10.5	79
BLT80	SOT223	c.w. class-B	7.5	900	0.8	> 6	85
BLT90/SL	SOT172	c.w. class-B	7.5	900	0.75	> 7	91
BLT91/SL	SOT172	c.w. class-B	7.5	900	1.5	> 6	99
BLT92/SL	SOT122	c.w. class-B	7.5	900	3	> 7	107
BLT93/SL	SOT122	c.w. class-B	7.5	900	6	> 5.5	115
BLU11/SL	SOT122D	c.w. class-B	12.5	470	2.5	> 10	123
BLU15/12	SOT122	c.w. class-B	12.5	470	15	> 7.8	129
BLU20/12	SOT119	c.w. class-B	12.5	470	20	> 6.5	137
BLU30/12	SOT119	c.w. class-B	12.5	470	30	> 6	145
						typ. 7.4	
BLU30/28	SOT119	c.w. class-B	28	470	30	> 8	153
BLU30/28	SOT119	c.w. class-B	24	470	25	typ. 8	153
BLU45/12	SOT119	c.w. class-B	12.5	470	45	> 4.8	161
BLU56	SOT223	c.w. class-B	12.5	470	1	> 12	169
BLU60/12	SOT119	c.w. class-B	12.5	470	60	> 4.4	177
BLU60/28	SOT119	c.w. class-B	28	470	60	> 7	185
BLU60/28	SOT119	c.w. class-B	24	470	50	typ. 7	185
BLU86	SOT223	c.w. class-B	12.5	900	1	> 7	193
BLU97	SOT122	c.w. class-B	12.5	470	7	> 8.5	199
BLU98	SOT103	c.w. class-B	12.5	900	0.5	> 8	207
BLU99	SOT122	c.w. class-B	12.5	470	5	> 10.5	215
			12.5	900	4	typ. 7	
BLV10	SOT123	c.w. class-B	13.5	175	8	> 9	227
			12.5	175	8	typ. 10.5	
			12	28	1 (note 1)	18	

## RF Power Bipolar Transistors

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TYPE	ENVELOPE	MODE OF OPERATION	V <sub>CE</sub> (V)	f (MHz)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	PAGE
BLV11	SOT123	c.w. class-B	13.5	175	15	> 8	235
			12.5	175	15	typ. 7.5	
		SSB class-A	12	28	2 (note 1)	18	
			13.5	28	10 (note 2)	18	
BLV12	SOT123	c.w. class-B	12.5	175	30	> 9	243
BLV20	SOT123	c.w. class-B	28	175	8	> 12	249
BLV21	SOT123	c.w. class-B	28	175	15	> 10	257
BLV25	SOT119	c.w. class-B	28	108	175	> 10	265
BLV30	SOT122	lin. ampl., class-A	25	225	1.5 (note 3)	> 18	273
			25	225	1.7 (note 3)	typ. 20	
BLV31	SOT122	lin. ampl., class-A	25	225	5 (note 3)	> 15	283
			25	225	7 (note 3)	typ. 16.5	
BLV32F	SOT160	lin. ampl., class-A	25	225	10 (note 4)	> 16	293
			25	225	12.5 (note 4)	typ. 17.2	
BLV33	SOT147	lin. ampl., class-A	25	225	19 (note 4)	> 9	303
			25	225	26 (note 4)	typ. 9.7	
BLV33F	SOT119	lin. ampl., class-A	28	225	90 (note 4)	typ. 6.5	315
			25	225	16 (note 4)	> 13.5	
BLV36	SOT161	lin. ampl., class-AB	25	225	22 (note 4)	typ. 14.8	329
			28	225	85 (note 4)	typ. 10.5	
BLV37	SOT179	c.w. class-B	28	225	115	> 11	341
			28	225	115	typ. 13	
			12.5	175	8	typ. 10.5	
BLV38	SOT179	lin. ampl., class-AB	28	108	250	> 10.5	347
						35	
BLV45/12	SOT119	c.w. class-B	12.5	175	45	> 8	353
BLV57	SOT161	lin. ampl., class-A	25	860	6 (note 4)	> 6.5	361
			25	860	12 (note 4)	> 8	
BLV59	SOT171	lin. ampl., class-AB	25	860	38	typ. 9	375
			25	860	30	typ. 6.5	
BLV75/12	SOT119	c.w. class-B	12.5	175	75	> 6.5	385
BLV80/28	SOT121	c.w. class-B	28	175	80	> 6.5	395
						75	
BLV90	SOT172	c.w. class-B	12.5	900	1	> 6.5	405
			9.6	900	0.75	typ. 7.9	

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TYPE	ENVELOPE	MODE OF OPERATION	V <sub>CE</sub> (V)	f (MHz)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	PAGE
BLV90/SL	SOT172	c.w. class-B	12.5	900	1	> 7.5	413
			9.6	900	1	typ. 7	
BLV91	SOT172	c.w. class-B	12.5	900	2	> 6.5	421
			9.6	900	1.5	typ. 6.6	
BLV91/SL	SOT172	c.w. class-B	12.5	900	2	> 6.5	429
			9.6	900	1.5	typ. 6.6	
BLV92	SOT171	c.w. class-B	12.5	900	4	> 7.5	437
			9.6	900	3	typ. 7.3	
BLV93	SOT171	c.w. class-B	12.5	900	8	> 6.5	445
			9.6	900	6	typ. 6	
BLV94	SOT171	c.w. class-B	12.5	900	15	> 6	455
						typ. 7	
BLV95	SOT171	c.w. class-B	12.5	900	22	> 5.5	465
BLV97	SOT171	c.w. class-B	24	900	30	> 7	473
						typ. 8	
BLV97CE	SOT171	c.w. class-AB	24	960	35	> 7	481
						typ. 8.5	
BLV98	SOT171	c.w. class-B	24	900	14	> 8.5	491
						typ. 10	
BLV98CE	SOT171	c.w. class-AB	24	960	15	> 7.5	499
						typ. 8.5	
BLV99	SOT172	c.w. class-B	24	900	2	> 8	509
						typ. 9.3	
BLV100	SOT171	c.w. class-AB	24	960	8	> 8	517
BLV101A	SOT273	c.w. class-AB	26	850 to 960	50	> 8.5	527
						typ. 9.5	
BLV101B	SOT273	c.w. class-AB	26	850 to 960	50	> 7.5	527
						typ. 8.4	
BLW29	SOT120	c.w. class-B	13.5	175	15	> 10	537
			12.5	175	15	typ. 10.5	
BLW30	SOT120	c.w. class-B	12.5	175	30	> 10	545
						typ. 11.5	
BLW31	SOT120	c.w. class-B	13.5	175	28	> 9	551
			12.5	175	28	typ. 9.5	
BLW32	SOT122	lin. ampl., class-A	25	860	0.5 (note 3)	> 11	559
			25	860	0.63 (note 3)	typ. 12.2	
BLW33	SOT122	lin. ampl., class-A	25	860	1 (note 3)	> 10	569
			25	860	1.15 (note 3)	typ. 10.5	
BLW34	SOT122	lin. ampl., class-A	25	860	1.8 (note 3)	> 9	579
			25	860	2.15 (note 3)	typ. 10.2	



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TYPE	ENVELOPE	MODE OF OPERATION	V <sub>CE</sub> (V)	f (MHz)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	PAGE
BLW50F	SOT123	SSB class-A	45	1.6 to 28	0 to 16 (note 1)	> 19.5	589
		SSB class-AB	50	1.6 to 28	10 to 65 (note 2)	typ. 18	
BLW60	SOT56	c.w. class-B	12.5	175	45	> 5	599
		SSB class-AB	12.5	1.6 to 28	3 to 30 (note 2)	typ. 19.5	
BLW60C	SOT120	c.w. class-B	12.5	175	45	> 5	613
		SSB class-AB	12.5	1.6 to 28	3 to 30 (note 2)	typ. 19.5	613
BLW76	SOT121	SSB class-AB	28	1.6 to 28	8 to 80 (note 2)	> 13	625
		c.w. class-B	28	108	80	typ. 7.9	
BLW77	SOT121	SSB class-AB	28	1.6 to 28	15 to 130 (note 2)	> 12	639
		c.w. class-B	28	87.5	130	typ. 7.5	
BLW78	SOT121	c.w. class-B	28	150	100	> 6	653
		SSB class-A	26	28	35 (note 1)	typ. 19.5	
		SSB class-AB	28	28	100 (note 2)	typ. 19	
BLW79	SOT122	c.w. class-B	12.5	470	2	> 9	667
			12.5	175	2	typ. 13.5	
BLW80	SOT122	c.w. class-B	12.5	470	4	> 8	675
			12.5	175	4	typ. 15	
BLW81	SOT122	c.w. class-B	12.5	470	10	> 6	683
			12.5	175	10	typ. 13.5	
BLW83	SOT123	SSB class-A	26	1.6 to 28	0 to 10 (note 1)	> 20	691
		SSB class-AB	28	1.6 to 28	3 to 30 (note 2)	typ. 21	
BLW84	SOT123	c.w. class-B	28	175	25	> 9	701
BLW85	SOT123	c.w. class-B	12.5	175	45	> 4.5	709
			13.5	175	45	typ. 6	
		SSB class-AB	12.5	1.6 to 28	3 to 30 (note 2)	typ. 19.5	
BLW86	SOT123	c.w. class-B	28	175	45	> 7.5	721
		SSB class-AB	28	1.6 to 28	5 to 47.5 (note 2)	typ. 19	
		SSB class-A	26	1.6 to 28	17 (note 1)	typ. 22	
BLW87	SOT123	c.w. class-B	13.5	175	25	> 6	735
						typ. 6.6	
BLW89	SOT122	c.w. class-B	28	470	2	> 12	743
						typ. 13.5	
BLW90	SOT122	c.w. class-B	28	470	4	> 11	751
						typ. 12.5	
BLW91	SOT122	c.w. class-B	28	470	10	> 9	759
						typ. 10.5	
BLW95	SOT121	SSB class-AB	50	1.6 to 28	20 to 160 (note 2)	> 14	767
BLW96	SOT121	SSB class-AB	50	1.6 to 28	25 to 200 (note 2)	> 13.5	777
		c.w. class-B	50	108	200	typ. 6.5	
		SSB class-A	40	28	50 (note 1)	typ. 19	

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TYPE	ENVELOPE	MODE OF OPERATION	V <sub>CE</sub> (V)	f (MHz)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	PAGE
BLW87	SOT123	c.w. class-B	13.5	175	25	> 6 typ. 6.6	735
BLW89	SOT122	c.w. class-B	28	470	2	> 12 typ. 13.5	743
BLW90	SOT122	c.w. class-B	28	470	4	> 11 typ. 12.5	751
BLW91	SOT122	c.w. class-B	28	470	10	> 9 typ. 10.5	759
BLW95	SOT121	SSB class-AB	50	1.6 to 28	20 to 160 (note 2)	> 14	767
BLW96	SOT121	SSB class-AB	50	1.6 to 28	25 to 200 (note 2)	> 13.5	777
		c.w. class-B	50	108	200	typ. 6.5	
		SSB class-A	40	28	50 (note 1)	typ. 19	
BLW97	SOT121	SSB class-AB	28	1.6 to 28	175 (note 2)	> 11.5	789
BLW98	SOT122	lin. ampl., class-A	25	860	3.5 (note 3)	> 6.5	797
			25	860	4.4 (note 3)	typ. 7	
BLW99	SOT121	SSB class-AB	12.5	1.6 to 28	80 (note 2)	> 12.5	807
BLX13	SOT56	SSB class-A	26	28	0 to 8 (note 1)	> 18	813
		SSB class-AB	28	28	25 (note 2)	> 18	
		c.w. class-B	28	70	25	typ. 17	
BLX13C	SOT120	SSB class-A	26	1.6 to 28	0 to 8 (note 1)	> 20	825
		SSB class-AB	28	1.6 to 28	3 to 25 (note 2)	typ. 21	
BLX14	SOT55	SSB class-A	28	1.6 to 28	25 (note 1)	> 13	835
		SSB class-AB	28	1.6 to 28	7.5 to 50 (note 2)	> 13	
		c.w. class-B	28	70	50	typ. 7.5	
		c.w. class-B	28	30	50	typ. 16	
BLX15	SOT55	SSB class-AB	50	1.6 to 28	20 to 150 (note 2)	> 14	849
		SSB class-A	40	1.6 to 28	30 (note 1)	> 14	
		c.w. class-B	50	70	150	> 10	
		c.w. class-B	50	108	150	typ. 7.4	
BLX39	SOT120	c.w. class-B	28	175	45	> 7.5	865
		SSB class-AB	28	1.6 to 28	5 to 42.5 (note 2)	typ. 19	
		SSB class-A	26	1.6 to 28	15 (note 1)	typ. 20	
BLX65	TO-39/1	c.w. class-B	13.8	470	2	typ. 7	879
		c.w. class-B	12.5	470	2	> 6	
		c.w. class-B	12.5	175	2	typ. 12	
BLX65E	TO-39/3	c.w. class-B	12.5	175	2	typ. 16	891
		c.w. class-B	12.5	470	2	> 9	
BLX65ES	TO-39/3	c.w. class-B	12.5	175	2	typ. 16	891
		c.w. class-B	12.5	470	2	> 9	

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TYPE	ENVELOPE	MODE OF OPERATION	V <sub>CE</sub> (V)	f (MHz)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	PAGE
BLX67	SOT48/3	c.w. class-B	13.8	470	1.5	typ. 10	895
			13.8	470	3	typ. 9.3	
			12.5	470	2.5	> 8.5	
			12.5	175	3	typ. 20	
BLX68	SOT48/3	c.w. class-B	13.8	470	7	> 5.4	907
			13.8	470	7.8	typ. 5.9	
			12.5	470	7	> 5	
			12.5	175	7.2	typ. 12.6	
BLX69A	SOT48/2	c.w. class-B	13.5	470	20	> 4	919
			12.5	470	17	> 4	
			12.5	175	17	typ. 11	
BLX91A	SOT48/3	c.w. class-B	24	470	0.85	typ. 12.3	927
			28	470	1	> 11	
			28	470	1.45	typ. 12.6	
			28	1000	1.4	typ. 5.4	
BLX91CB	SOT48/3	video CRT driver	28	V <sub>CESM</sub>	max. 65 V; C <sub>c</sub> typ. 3 pF		937
BLX92A	SOT48/3	c.w. class-B	24		470	2.4	typ. 10.8
			28	470	2.5	> 11	
			28	470	3	typ. 11.7	
			28	1000	2.5	typ. 5.5	
BLX93A	SOT48/3	c.w. class-B	24	470	7	typ. 8.5	951
			28	470	7	> 8.5	
			28	470	8	typ. 9	
			28	1000	5	typ. 5.2	
BLX94A	SOT48/2	c.w. class-B	28	470	25	> 6	961
						typ. 6.5	
BLX94C	SOT122	c.w. class-B	28	470	25	> 6.5	961
						typ. 7.25	
BLX95	SOT56	c.w. class-B	28	470	40	< 4.5	971
			28	175	40	typ. 11	
BLX96	SOT48/3	lin. ampl., class-A	25	860	0.5 (note 3)	> 6	981
			25	860	0.6 (note 3)	typ. 7	
BLX97	SOT48/3	lin. ampl., class-A	25	860	1 (note 3)	> 5.5	989
			25	860	1.1 (note 3)	typ. 6.5	
BLX98	SOT48/2	lin. ampl., class-A	25	860	3.5 (note 3)	> 5	997
			25	860	4 (note 3)	typ. 5.5	
BLY87A	SOT48/2	c.w. class-B	13.5	175	8	> 9	1007
			12.5	175	8	typ. 9	

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TYPE	ENVELOPE	MODE OF OPERATION	V <sub>CE</sub> (V)	f (MHz)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	PAGE
BLY87C	SOT120	c.w. class-B	13.5	175	8	> 12	1015
		c.w. class-B	12.5	175	8	typ. 11.5	
BLY87C/01	SOT122	c.w. class-B	13.5	175	8	> 9	1023
		c.w. class-B	12.5	175	8	typ. 9	
BLY88A	SOT48/2	c.w. class-B	13.5	175	15	> 7.5	1031
		c.w. class-B	12.5	175	15	typ. 7.5	
BLY88C	SOT120	c.w. class-B	13.5	175	15	> 8	1039
		c.w. class-B	12.5	175	15	typ. 7.5	
BLY88C/01	SOT122	c.w. class-B	13.5	175	15	> 7.5	1047
		c.w. class-B	12.5	175	15	typ. 7.5	
BLY89A	SOT56	c.w. class-B	13.5	175	25	> 6	1055
BLY89C	SOT120	c.w. class-B	13.5	175	25	> 6	1065
						typ. 6.6	
BLY90	SOT55	c.w. class-B	12.5	175	50	> 5	1073
BLY91A	SOT48/2	c.w. class-B	28	175	8	> 12	1081
BLY91C	SOT120	c.w. class-B	28	175	8	> 12	1089
BLY92A	SOT48/2	c.w. class-B	28	175	15	> 10	1097
BLY92C	SOT120	c.w. class-B	28	175	15	> 10	1105
BLY93A	SOT56	c.w. class-B	28	175	25	> 9	1113
BLY93C	SOT120	c.w. class-B	28	175	25	> 9	1121
BLY94	SOT55	c.w. class-B	28	175	50	> 7	1129
2N3375	TO-60	c.w. class-B	28	100	7.5	> 8.8	1137
		c.w. class-B	28	400	> 3	> 4.8	
2N3553	TO-39/1	c.w. class-B	28	175	2.5	> 10	1137
2N3632	TO-60	c.w. class-B	28	175	> 13.5	> 5.9	1137
2N3866	TO-39/1	c.w. class-B	28	400	1	> 10	1153
2N3924	TO-39/1	c.w. class-B	13.5	175	4	> 6	1161
2N3926	TO-60	c.w. class-B	13.5	175	7	> 5.4	1161
2N3927	TO-60	c.w. class-B	13.5	175	12	> 4.8	1161
2N4427	TO-39/1	c.w. class-B	12	175	1	> 10	1153

## Notes

1. PEP at d<sub>3</sub> < -40 dB.
2. PEP at d<sub>3</sub> typ. -30 dB.
3. P<sub>o sync</sub> at d<sub>m</sub> < -60 dB.
4. P<sub>o sync</sub> at d<sub>m</sub> < -55 dB.

## GENERAL

**Type designation**

**Rating systems**

**Letter symbols**

**Mounting recommendations**



## PRO ELECTRON TYPE DESIGNATION CODE FOR SEMICONDUCTOR DEVICES

This type designation code applies to discrete semiconductor devices — as opposed to integrated circuits —, multiples of such devices and semiconductor chips.

“Although not all type numbers accord with the Pro Electron system, the following explanation is given for the ones that do.”

A basic type number consists of:

*TWO LETTERS FOLLOWED BY A SERIAL NUMBER*

### FIRST LETTER

The first letter gives information about the material used for the active part of the devices.

- A. GERMANIUM or other material with band gap of 0,6 to 1,0 eV.
- B. SILICON or other material with band gap of 1,0 to 1,3 eV.
- C. GALLIUM-ARSENIDE or other material with band gap of 1,3 eV or more.
- R. COMPOUND MATERIALS (e.g. Cadmium-Sulphide).

### SECOND LETTER

The second letter indicates the function for which the device is primarily designed.

- A. DIODE; signal, low power
- B. DIODE; variable capacitance
- C. TRANSISTOR; low power, audio frequency ( $R_{th\ j-mb} > 15\ K/W$ )
- D. TRANSISTOR; power, audio frequency ( $R_{th\ j-mb} \leq 15\ K/W$ )
- E. DIODE; tunnel
- F. TRANSISTOR; low power, high frequency ( $R_{th\ j-mb} > 15\ K/W$ )
- G. MULTIPLE OF DISSIMILAR DEVICES — MISCELLANEOUS; e.g. oscillator
- H. DIODE; magnetic sensitive
- L. TRANSISTOR; power, high frequency ( $R_{th\ j-mb} \leq 15\ K/W$ )
- N. PHOTO-COUPLER
- P. RADIATION DETECTOR; e.g. high sensitivity phototransistor
- Q. RADIATION GENERATOR; e.g. light-emitting diode (LED)
- R. CONTROL AND SWITCHING DEVICE; e.g. thyristor, low power ( $R_{th\ j-mb} > 15\ K/W$ )
- S. TRANSISTOR; low power, switching ( $R_{th\ j-mb} > 15\ K/W$ )
- T. CONTROL AND SWITCHING DEVICE; e.g. thyristor, power ( $R_{th\ j-mb} \leq 15\ K/W$ )
- U. TRANSISTOR; power, switching ( $R_{th\ j-mb} \leq 15\ K/W$ )
- X. DIODE; multiplier, e.g. varactor, step recovery
- Y. DIODE; rectifying, booster
- Z. DIODE; voltage reference or regulator (transient suppressor diode, with third letter W)

## SERIAL NUMBER

Three figures, running from 100 to 999, for devices primarily intended for consumer equipment.\* One letter (Z, Y, X, etc.) and two figures, running from 10 to 99, for devices primarily intended for industrial/professional equipment.\*

This letter has no fixed meaning except W, which is used for transient suppressor diodes.

## VERSION LETTER

It indicates a minor variant of the basic type either electrically or mechanically. The letter never has a fixed meaning, except letter R, indicating reverse voltage, e.g. collector to case or anode to stud.

## SUFFIX

Sub-classification can be used for devices supplied in a wide range of variants called associated types. Following sub-coding suffixes are in use:

### 1. VOLTAGE REFERENCE and VOLTAGE REGULATOR DIODES: *ONE LETTER and ONE NUMBER*

The LETTER indicates the nominal tolerance of the Zener (regulation, working or reference) voltage

- A. 1% (according to IEC 63: series E96)
- B. 2% (according to IEC 63: series E48)
- C. 5% (according to IEC 63: series E24)
- D. 10% (according to IEC 63: series E12)
- E. 20% (according to IEC 63: series E6)

The number denotes the typical operating (Zener) voltage related to the nominal current rating for the whole range.

The letter 'V' is used instead of the decimal point.

### 2. TRANSIENT SUPPRESSOR DIODES: *ONE NUMBER*

The NUMBER indicates the maximum recommended continuous reversed (stand-off) voltage  $V_R$ . The letter 'V' is used as above.

### 3. CONVENTIONAL and CONTROLLED AVALANCHE RECTIFIER DIODES and THYRISTORS: *ONE NUMBER*

The NUMBER indicates the rated maximum repetitive peak reverse voltage ( $V_{RRM}$ ) or the rated repetitive peak off-state voltage ( $V_{DRM}$ ), whichever is the lower. Reversed polarity is indicated by letter R, immediately after the number.

### 4. RADIATION DETECTORS: *ONE NUMBER*, preceded by a hyphen (-)

The NUMBER indicates the depletion layer in  $\mu\text{m}$ . The resolution is indicated by a version LETTER.

### 5. ARRAY OF RADIATION DETECTORS and GENERATORS: *ONE NUMBER*, preceded by a stroke (/).

The NUMBER indicates how many basic devices are assembled into the array.

\* When these serial numbers are exhausted the serial number for consumer types may be extended to four figures, and that for industrial types to three figures.



## RATING SYSTEMS

The rating systems described are those recommended by the International Electrotechnical Commission (IEC) in its Publication 134.

### DEFINITIONS OF TERMS USED

*Electronic device.* An electronic tube or valve, transistor or other semiconductor device.

#### Note

This definition excludes inductors, capacitors, resistors and similar components.

*Characteristic.* A characteristic is an inherent and measurable property of a device. Such a property may be electrical, mechanical, thermal, hydraulic, electro-magnetic, or nuclear, and can be expressed as a value for stated or recognized conditions. A characteristic may also be a set of related values, usually shown in graphical form.

*Bogey electronic device.* An electronic device whose characteristics have the published nominal values for the type. A bogey electronic device for any particular application can be obtained by considering only those characteristics which are directly related to the application.

*Rating.* A value which establishes either a limiting capability or a limiting condition for an electronic device. It is determined for specified values of environment and operation, and may be stated in any suitable terms.

#### Note

Limiting conditions may be either maxima or minima.

*Rating system.* The set of principles upon which ratings are established and which determine their interpretation.

#### Note

The rating system indicates the division of responsibility between the device manufacturer and the circuit designer, with the object of ensuring that the working conditions do not exceed the ratings.

### ABSOLUTE MAXIMUM RATING SYSTEM

Absolute maximum ratings are limiting values of operating and environmental conditions applicable to any electronic device of a specified type as defined by its published data, which should not be exceeded under the worst probable conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device, taking no responsibility for equipment variations, environmental variations, and the effects of changes in operating conditions due to variations in the characteristics of the device under consideration and of all other electronic devices in the equipment.

The equipment manufacturer should design so that, initially and throughout life, no absolute maximum value for the intended service is exceeded with any device under the worst probable operating conditions with respect to supply voltage variation, equipment component variation, equipment control adjustment, load variations, signal variation, environmental conditions, and variations in characteristics of the device under consideration and of all other electronic devices in the equipment.

## **DESIGN MAXIMUM RATING SYSTEM**

Design maximum ratings are limiting values of operating and environmental conditions applicable to a bogey electronic device of a specified type as defined by its published data, and should not be exceeded under the worst probable conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device, taking responsibility for the effects of changes in operating conditions due to variations in the characteristics of the electronic device under consideration.

The equipment manufacturer should design so that, initially and throughout life, no design maximum value for the intended service is exceeded with a bogey device under the worst probable operating conditions with respect to supply voltage variation, equipment component variation, variation in characteristics of all other devices in the equipment, equipment control adjustment, load variation, signal variation and environmental conditions.

## **DESIGN CENTRE RATING SYSTEM**

Design centre ratings are limiting values of operating and environmental conditions applicable to a bogey electronic device of a specified type as defined by its published data, and should not be exceeded under normal conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device in average applications, taking responsibility for normal changes in operating conditions due to rated supply voltage variation, equipment component variation, equipment control adjustment, load variation, signal variation, environmental conditions, and variations in the characteristics of all electronic devices.

The equipment manufacturer should design so that, initially, no design centre value for the intended service is exceeded with a bogey electronic device in equipment operating at the stated normal supply voltage.

## LETTER SYMBOLS FOR TRANSISTORS AND SIGNAL DIODES

based on IEC Publication 148

## LETTER SYMBOLS FOR CURRENTS, VOLTAGES AND POWERS

**Basic letters**

The basic letters to be used are:

I, i = current  
 V, v = voltage  
 P, p = power.

Lower-case basic letters shall be used for the representation of instantaneous values which vary with time.

In all other instances upper-case basic letters shall be used.

**Subscripts**

A, a	Anode terminal
(AV), (av)	Average value
B, b	Base terminal, for MOS devices: Substrate
(BR)	Breakdown
C, c	Collector terminal
D, d	Drain terminal
E, e	Emitter terminal
F, f	Forward
G, g	Gate terminal
K, k	Cathode terminal
M, m	Peak value
O, o	As third subscript: The terminal not mentioned is open circuited
R, r	As first subscript: Reverse. As second subscript: Repetitive. As third subscript: With a specified resistance between the terminal not mentioned and the reference terminal.
(RMS), (rms)	Root-mean-square value
S, s	{ As first or second subscript: Source terminal (for FETS only) As second subscript: Non-repetitive (not for FETS) As third subscript: Short circuit between the terminal not mentioned and the reference terminal
X, x	Specified circuit
Z, z	Replaces R to indicate the actual working voltage, current or power of voltage reference and voltage regulator diodes.

Note: No additional subscript is used for DC values.

Upper-case subscripts shall be used for the indication of:

- a) continuous (DC) values (without signal)  
Example  $I_B$
- b) instantaneous total values  
Example  $i_B$
- c) average total values  
Example  $I_{B(AV)}$
- d) peak total values  
Example  $I_{BM}$
- e) root-mean-square total values  
Example  $I_{B(RMS)}$

Lower-case subscripts shall be used for the indication of values applying to the varying component alone:

- a) instantaneous values  
Example  $i_b$
- b) root-mean-square values  
Example  $I_{b(rms)}$
- c) peak values  
Example  $I_{bm}$
- d) average values  
Example  $I_{b(av)}$

Note: If more than one subscript is used, subscript for which both styles exist shall either be all upper-case or all lower-case.

## **Additional rules for subscripts**

### Subscripts for currents

Transistors: If it is necessary to indicate the terminal carrying the current, this should be done by the first subscript (conventional current flow from the external circuit into the terminal is positive).

Examples:  $I_B$ ,  $i_B$ ,  $i_b$ ,  $I_{bm}$

Diodes: To indicate a forward current (conventional current flow into the anode terminal) the subscript F or f should be used; for a reverse current (conventional current flow out of the anode terminal) the subscript R or r should be used.

Examples:  $I_F$ ,  $I_R$ ,  $i_F$ ,  $I_{f(rms)}$

Subscripts for voltages

Transistors: If it is necessary to indicate the points between which a voltage is measured, this should be done by the first two subscripts. The first subscript indicates the terminal at which the voltage is measured and the second the reference terminal or the circuit node. Where there is no possibility of confusion, the second subscript may be omitted.

Examples:  $V_{BE}$ ,  $v_{BE}$ ,  $v_{be}$ ,  $V_{bem}$

Diodes: To indicate a forward voltage (anode positive with respect to cathode), the subscript F or f should be used; for a reverse voltage (anode negative with respect to cathode) the subscript R or r should be used.

Examples:  $V_F$ ,  $V_R$ ,  $v_F$ ,  $V_{rm}$

Subscripts for supply voltages or supply currents

Supply voltages or supply currents shall be indicated by repeating the appropriate terminal subscript.

Examples:  $V_{CC}$ ,  $I_{EE}$

Note: If it is necessary to indicate a reference terminal, this should be done by a third subscript

Example:  $V_{CCE}$

Subscripts for devices having more than one terminal of the same kind

If a device has more than one terminal of the same kind, the subscript is formed by the appropriate letter for the terminal followed by a number; in the case of multiple subscripts, hyphens may be necessary to avoid misunderstanding.

Examples:  $I_{B2}$  = continuous (DC) current flowing into the second base terminal

$V_{B2-E}$  = continuous (DC) voltage between the terminals of second base and emitter

Subscripts for multiple devices

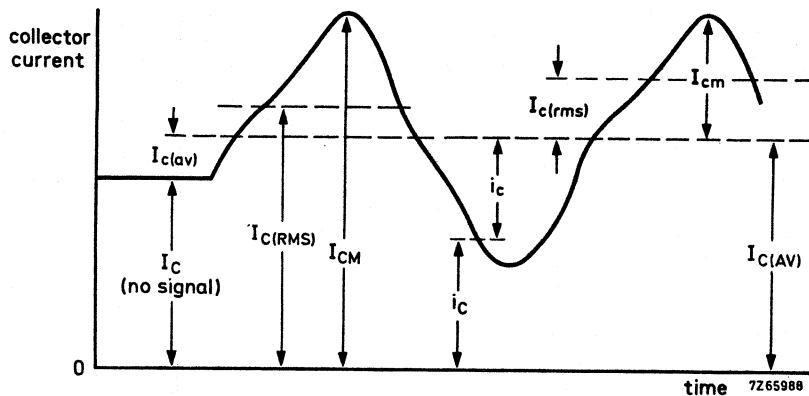
For multiple unit devices, the subscripts are modified by a number preceding the letter subscript; in the case of multiple subscripts, hyphens may be necessary to avoid misunderstanding.

Examples:  $I_{2C}$  = continuous (DC) current flowing into the collector terminal of the second unit

$V_{1C-2C}$  = continuous (DC) voltage between the collector terminals of the first and the second unit.

## Application of the rules

The figure below represents a transistor collector current as a function of time. It consists of a continuous (DC) current and a varying component.



## LETTER SYMBOLS FOR ELECTRICAL PARAMETERS

### Definition

For the purpose of this Publication, the term "electrical parameter" applies to four-pole matrix parameters, elements of electrical equivalent circuits, electrical impedances and admittances, inductances and capacitances.

### Basic letters

The following is a list of the most important basic letters used for electrical parameters of semiconductor devices.

- B, b = susceptance; imaginary part of an admittance
- C = capacitance
- G, g = conductance; real part of an admittance
- H, h = hybrid parameter
- L = inductance
- R, r = resistance; real part of an impedance
- X, x = reactance; imaginary part of an impedance
- Y, y = admittance;
- Z, z = impedance;

Upper-case letters shall be used for the representation of:

- a) electrical parameters of external circuits and of circuits in which the device forms only a part;
- b) all inductances and capacitances.

Lower-case letters shall be used for the representation of electrical parameters inherent in the device (with the exception of inductances and capacitances).

### Subscripts

#### General subscripts

The following is a list of the most important general subscripts used for electrical parameters of semiconductor devices:

F, f	= forward; forward transfer
I, i (or 1)	= input
L, l	= load
O, o (or 2)	= output
R, r	= reverse; reverse transfer
S, s	= source

Examples:  $Z_S$ ,  $h_f$ ,  $h_F$

The upper-case variant of a subscript shall be used for the designation of static (d.c.) values.

Examples :  $h_{FE}$  = static value of forward current transfer ratio in common-emitter configuration (DC current gain)

$R_E$  = DC value of the external emitter resistance

Note: The static value is the slope of the line from the origin to the operating point on the appropriate characteristic curve, i.e. the quotient of the appropriate electrical quantities at the operating point.

The lower-case variant of a subscript shall be used for the designation of small-signal values.

Examples:  $h_{fe}$  = small-signal value of the short-circuit forward current transfer ratio in common-emitter configuration

$Z_e = R_e + jX_e$  = small-signal value of the external impedance

Note: If more than one subscript is used, subscripts for which both styles exist shall either be all upper-case or all lower-case

Examples:  $h_{FE}$ ,  $y_{RE}$ ,  $h_{fe}$

Subscripts for four-pole matrix parameters

The first letter subscript (or double numeric subscript) indicates input, output, forward transfer or reverse transfer

Examples:  $h_i$  (or  $h_{11}$ )  
 $h_o$  (or  $h_{22}$ )  
 $h_f$  (or  $h_{21}$ )  
 $h_r$  (or  $h_{12}$ )

A further subscript is used for the identification of the circuit configuration. When no confusion is possible, this further subscript may be omitted.

Examples:  $h_{fe}$  (or  $h_{21e}$ ),  $h_{FE}$  (or  $h_{21E}$ )

**Distinction between real and imaginary parts**

If it is necessary to distinguish between real and imaginary parts of electrical parameters, no additional subscripts should be used. If basic symbols for the real and imaginary parts exist, these may be used.

Examples:  $Z_i = R_i + jX_i$   
 $y_{fe} = g_{fe} + jb_{fe}$

If such symbols do not exist or if they are not suitable, the following notation shall be used:

Examples:  $\text{Re}(h_{ib})$  etc. for the real part of  $h_{ib}$   
 $\text{Im}(h_{ib})$  etc. for the imaginary part of  $h_{ib}$



RECOMMENDATIONS FOR MOUNTING  
FLANGE RF POWER TRANSISTORS

Flange RF transistors are easy to mount but for optimum performance we offer the following recommendations:

- Holes or tapped holes in the heatsink should be free from burrs. They must have a depth of at least 6 mm.  
Recommended screw: for SOT119, SOT121 and SOT161 cheese-head 4-40 UNC/2A, for SOT123 and SOT160 also M3. A washer to spread the joint pressure is also recommended.
- For transistors dissipating up to 80 W the heatsink thickness should be at least 3 mm copper (> 99,9%, ETP-Cu) or 5 mm aluminium (> 99,0% Al). For transistors dissipating more power, the thickness should be increased proportionally.
- The flatness of the heatsink mounting surface must be > 0,02 mm with a surface roughness  $R_a < 0,5 \mu\text{m}$  (preferably by grinding or lapping).
- The sparing use of evenly distributed heatsink compound on the transistor flange is recommended. Suitable heatsink compound brands are: Dow Corning 340, Eccotherm TC-5 (E&C), Wakefield 120.
- The screws through the flange holes should first both be tightened to 0,05 Nm (finger tight), and then tightened to 0,6 to 0,75 Nm, to achieve the published thermal resistance between the mounting base and heatsink.
- When a transistor is removed from the heatsink, the flange will almost certainly have been distorted by the joint pressure. Grinding or lapping of the flange according to the information above is necessary if the transistor is remounted.

## RECOMMENDATIONS FOR MOUNTING 1/4", 3/8" AND 1/2" CAPSTAN HEADERS AS USED FOR R.F. POWER TRANSISTORS

A nickel plated brass nut is supplied with each transistor for securing it to a heatsink.

Screw threads, diameter and nuts:

mounting base diameter	thread	maximum diameter of threaded stud	nut thickness
1/4"	8-32UNC-2A(B)	4,14 mm	3,5 and 5 mm
3/8"	10-32UNF-2A(B)	4,80 mm	5 mm
1/2"	1/4" x 28UNF-2A(B)	6,33 mm	5,5 mm

To ensure optimum heat transfer and to avoid damage to the threaded stud of the transistor the following recommendations should be observed.

– Diameter of the mounting hole in the heatsink:

1/4" stud	diameter 4,15 +0,05; –0 mm
3/8" stud	diameter 4,85 +0,05; –0 mm
1/2" stud	diameter 6,35 +0,05; –0 mm

Heatsink surfaces at the mounting hole to be flat, parallel, and free of burrs or oxidation.

– Mounting nut torque:

1/4" nut	minimum 0,75 Nm (7,5 kg cm)	maximum 0,85 Nm (8,5 kg cm)
3/8" nut	minimum 1,5 Nm (15 kg cm)	maximum 1,7 Nm (17 kg cm)
1/2" nut	minimum 2,3 Nm (23 kg cm)	maximum 2,7 Nm (27 kg cm)

– Recommended distance from the surface of the heatsink to the top surface of the printed-circuit board:

1/4" capstan header	2,9 + 0; –0,2 mm
3/8" capstan header	3,8 + 0; –0,2 mm
1/2" capstan header	4,8 + 0; –0,2 mm

It is important that the above maximum printed-circuit board mounting heights are not exceeded in order to prevent stress being applied to the encapsulation. Upward lead bending, in particular, can damage the encapsulation and impair the sealing of the header.

- Experience indicates that flux or flux solutions can penetrate even hermetically sealed ceramic-capped transistors. To prevent this, tin and wash the printed-circuit boards before mounting the power transistors, then solder the transistors in place without using flux.
- The leads may be tinned by dipping them, full length, into a solder bath at about 230 °C. Note, no flux should be used during tinning.
- The full mounting-nut torque (specified above) should be applied only once during the life of the transistor. For pre-assembly testing, apply no more than two thirds of the specified torque.
- Since locking washers are much harder than most heatsink materials, their locking action might deteriorate during the life of the transistor. The use of locking washers is therefore not recommended. Instead, tighten the nuts to their specified torque, allow about 30 minutes for them to bed down, then re-tighten. After this, apply locking paint.

## DEVICE DATA



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B or C operated mobile transmitters with a nominal supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V. The BFQ42 is especially suited as a driver transistor for the BLW29 in a two-stage wideband or semi-wideband v.h.f. amplifier delivering 15 W output power.

It has a TO-39 metal envelope with the collector connected to the case.

### QUICK REFERENCE DATA

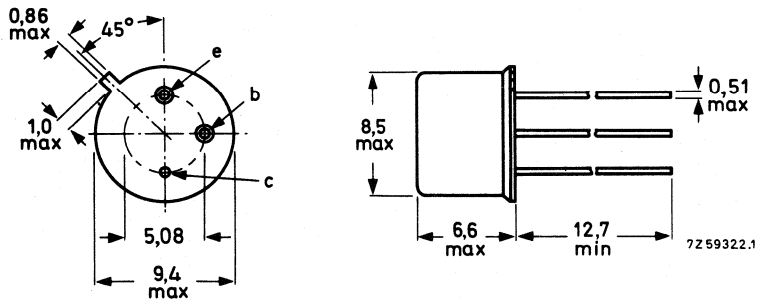
R.F. performance up to  $T_{amb} = 25\text{ }^{\circ}\text{C}$ ;  $R_{th\ c-a} = 32\text{ K/W}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w. class-B	13,5	175	2	> 11	> 60	7,8 - j4,6	22 - j18
c.w. class-B	12,5	175	2	typ. 10,5	typ. 65	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-39; collector connected to case.



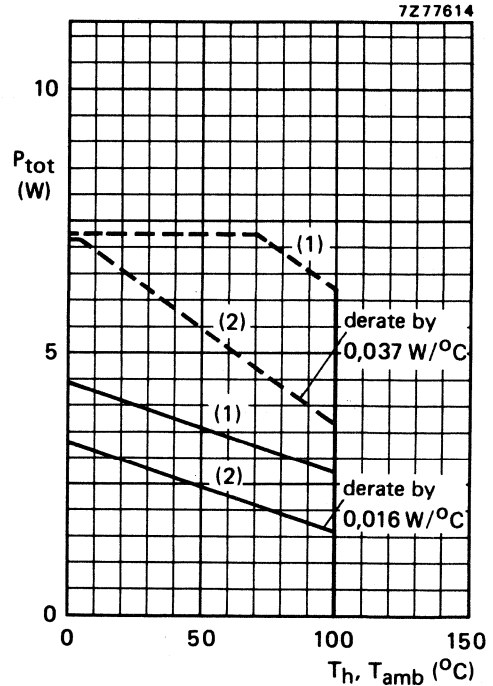
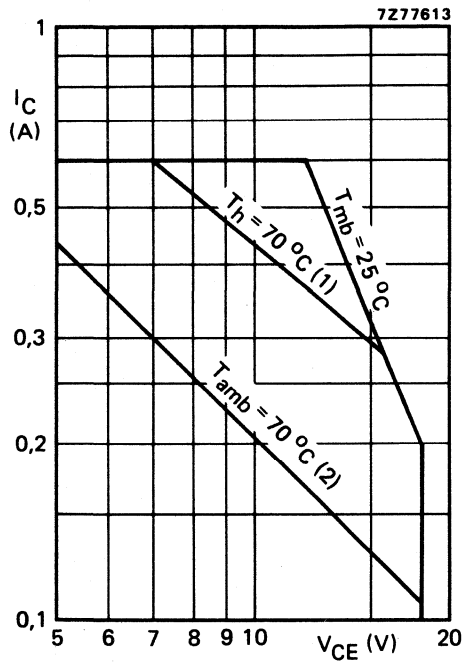
Maximum lead diameter is guaranteed only for 12,7 mm.

**RATINGS**

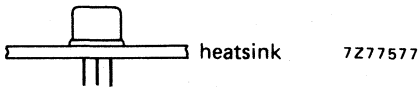
Limiting values in accordance with the Absolute Maximum System (IEC 134)

- Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value
- Collector-emitter voltage (open base)
- Emitter-base voltage (open collector)
- Collector current (average)
- Collector current (peak value);  $f > 1$  MHz
- Total power dissipation up to  $T_{mb} = 25$  °C
- Storage temperature
- Junction temperature

$V_{CESM}$	max.	36 V
$V_{CEO}$	max.	18 V
$V_{EBO}$	max.	4 V
$I_{C(AV)}$	max.	0,6 A
$I_{CM}$	max.	1,8 A
$P_{tot}$	max.	7,2 W
$T_{stg}$		-65 to + 200 °C
$T_j$	max.	200 °C



(1) Mounted on a heatsink.



(2) Free-air operation; using a spring cooling clip.

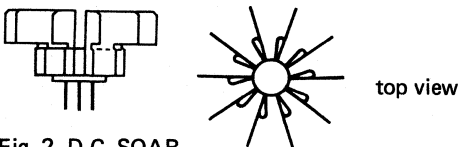


Fig. 2 D.C. SOAR.

(1) Short-time r.f. operation during mismatch;  
 $R_{th\ mb-h} = 3$  K/W;  $R_{th\ c-a} = 32$  K/W;  
 $f \geq 1$  MHz.

(2) Continuous d.c. and r.f. operation;  
 $R_{th\ mb-h} = 3$  K/W;  $R_{th\ c-a} = 32$  K/W.

Fig. 3 Total power dissipation;  $V_{CE} \leq 16,5$  V.

- Mounted on a heatsink.
- Free-air operation; using a spring cooling clip having a thermal resistance of 32 K/W.

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	24 K/W
From junction to case	$R_{th\ j-c}$	=	29 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	3 K/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 2\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 25\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 1\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 1\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\ \Omega$  $ESBO > 0,5\text{ mJ}$  $ESBR > 0,5\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,25\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 30  
10 to 60

Collector-emitter saturation voltage\*

 $I_C = 0,75\text{ A}; I_B = 0,15\text{ A}$  $V_{CEsat}$  typ. 0,9 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 0,25\text{ A}; V_{CB} = 13,5\text{ V}$  $-I_E = 0,75\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 750 MHz $f_T$  typ. 625 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 13,5\text{ V}$  $C_c$  typ. 8,6 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 20\text{ mA}; V_{CE} = 13,5\text{ V}$  $C_{re}$  typ. 3,8 pF\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}; \delta \leq 0,02$ .

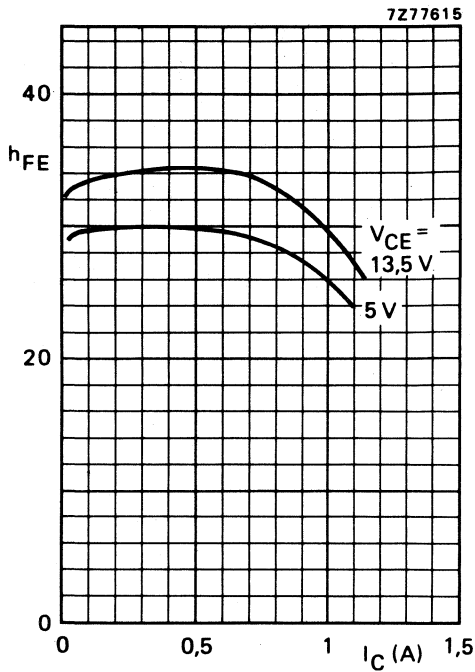


Fig. 4 Typical values;  $T_j = 25^\circ\text{C}$ .

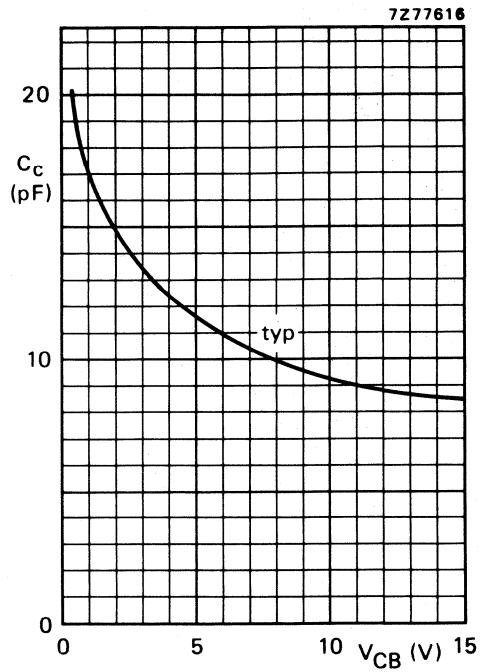


Fig. 5  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25^\circ\text{C}$ .

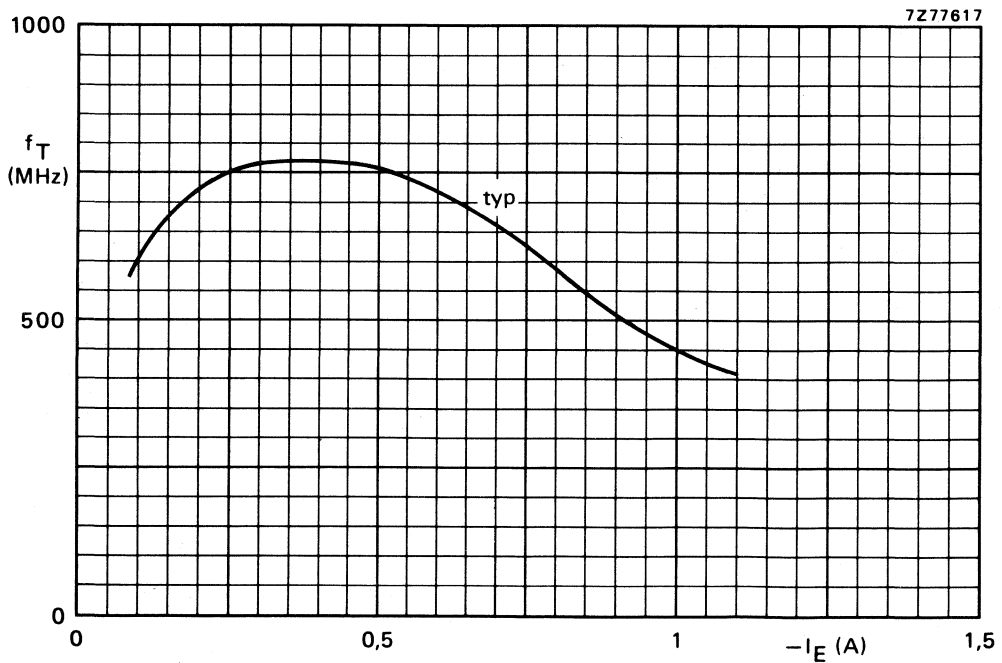


Fig. 6  $V_{CB} = 13.5$  V;  $f = 100$  MHz;  $T_j = 25^\circ\text{C}$ .

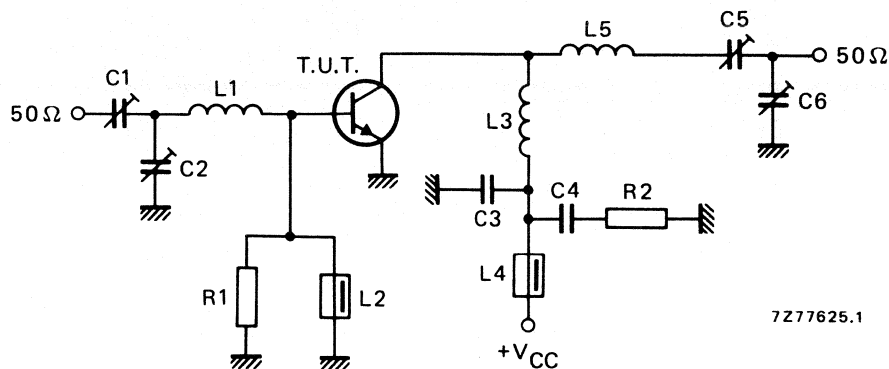


## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_{amb} = 25\text{ }^{\circ}\text{C}$ ;  $R_{th\ c-a} = 32\text{ }^{\circ}\text{C/W}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	13,5	2	< 0,16	> 11	< 0,25	> 60	7,8 - j4,6	22 - j18
175	12,5	2	-	typ. 10,5	-	typ. 65	-	-



7277625.1

Fig. 7 Test circuit; c.w. class-B.

List of components:

C1 = C2 = C5 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 100 pF ceramic capacitor

C4 = 100 nF polyester capacitor

C6 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

L1 = 3 turns enamelled Cu wire (1,0 mm); int. dia. 4,0 mm; length 4 mm; leads 2 x 5 mm

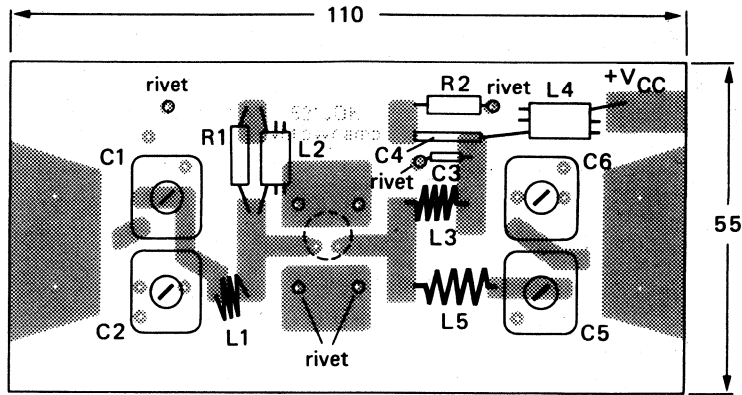
L2 = L4 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L5 = 4 turns Cu wire (1,0 mm); int. dia. 6,0 mm; length 6 mm; leads 2 x 5 mm

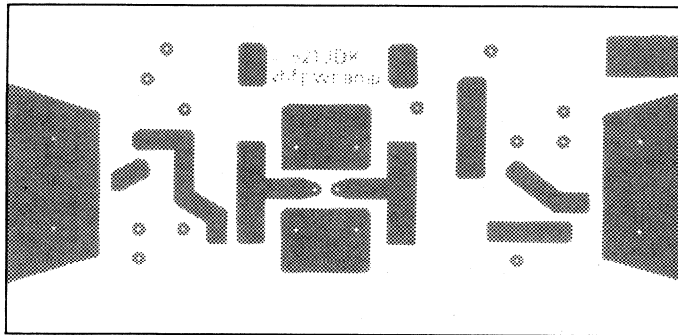
R1 = 220  $\Omega$  carbon resistorR2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit are shown in Fig. 8.

APPLICATION INFORMATION (continued)



7Z77578.1



7Z77579

Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.

Material of printed-circuit board: 1,6 mm epoxy fibre-glass.

The length of the external emitter lead is 1,2 mm.

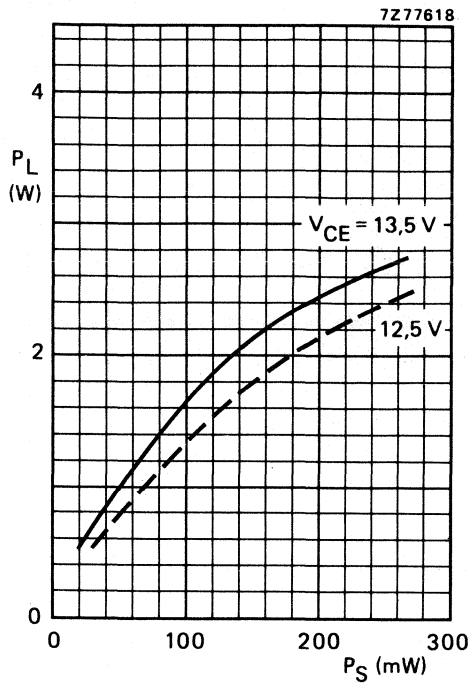


Fig. 9 Typical values;  $f = 175\text{ MHz}$ ;  
 $T_{amb} = 25\text{ }^\circ\text{C}$ ;  $R_{th\ c-a} = 32\text{ K/W}$ .

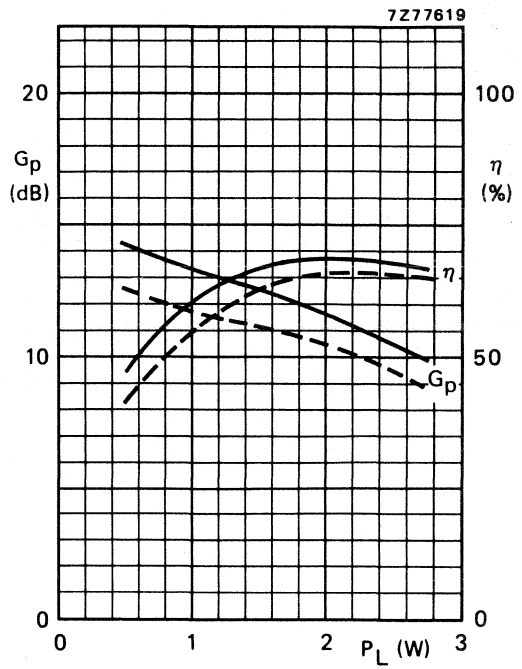


Fig. 10 Typical values;  $f = 175\text{ MHz}$ ;  
 $T_{amb} = 25\text{ }^\circ\text{C}$ ; —  $V_{CE} = 13,5\text{ V}$ ;  
 ---  $V_{CE} = 12,5\text{ V}$ ;  $R_{th\ c-a} = 32\text{ K/W}$ .

APPLICATION INFORMATION (continued)

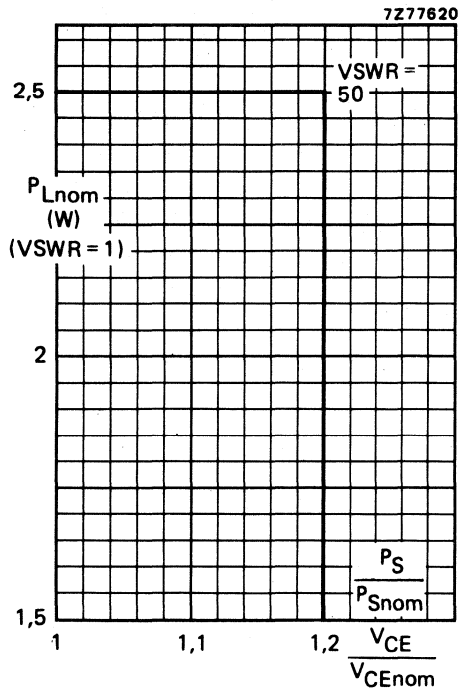


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 3 \text{ K/W}$ ;  $V_{CEnom} = 13,5 \text{ V}$  or  $12,5 \text{ V}$ ;  $P_S = P_{Snom}$  at  $V_{CEnom}$  and  $VSWR = 1$ .

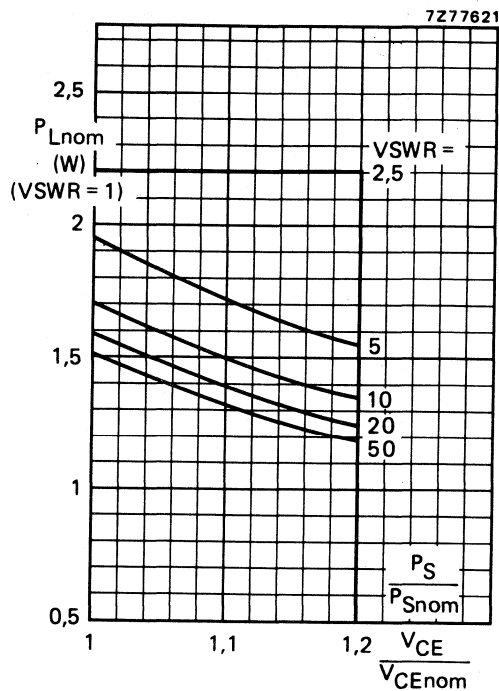


Fig. 12 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ }^\circ\text{C}$ ;  $T_{amb} = 70 \text{ }^\circ\text{C}$ ;  $R_{th \text{ c-a}} = 32 \text{ K/W}$ ;  $V_{CEnom} = 13,5 \text{ V}$  or  $12,5 \text{ V}$ ;  $P_S = P_{Snom}$  at  $V_{CEnom}$  and  $VSWR = 1$ .

Note to Figs 11 and 12:

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ), as a function of the expected supply over-voltage ratio with  $VSWR$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 100 MHz a base-emitter resistor of 22  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

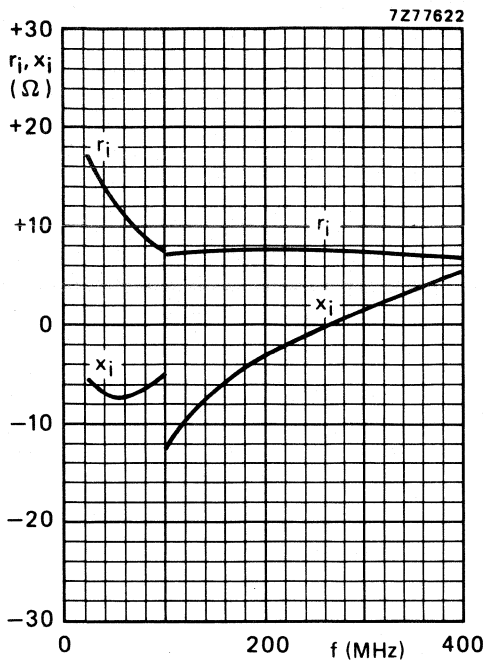


Fig. 13.

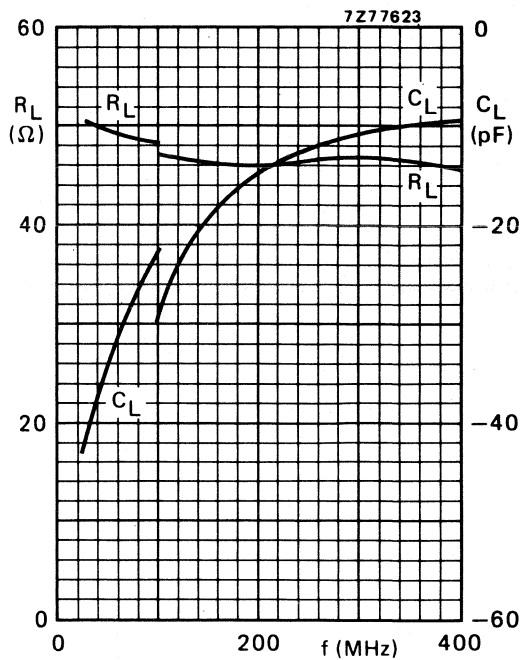


Fig. 14.

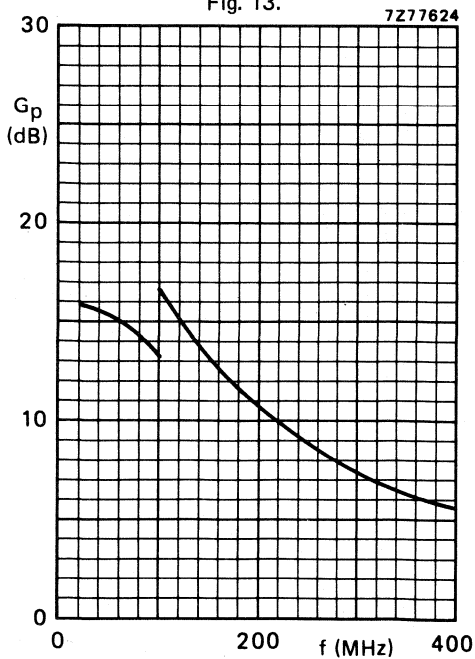


Fig. 15.

Conditions for Figs 13, 14 and 15:  
 Typical values;  $V_{CE} = 13.5 \text{ V}$ ;  $P_L = 2 \text{ W}$ ;  
 $T_{amb} = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ c-a}} = 32 \text{ K/W}$ .



## V.H.F. POWER TRANSISTORS

N-P-N silicon planar epitaxial transistors intended for use in class-A, B or C operated mobile transmitters with a nominal supply voltage of 13,5 V. The transistors are resistance stabilized and guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V. The BFQ43 and BFQ43S are especially suited as driver transistors for the BLW31 in a two-stage wideband or semi-wideband v.h.f. amplifier delivering 28 W output power.

The BFQ43 and BFQ43S have a TO-39 metal envelope with the emitter connected to the case which enables excellent heatsinking and emitter grounding.

### QUICK REFERENCE DATA

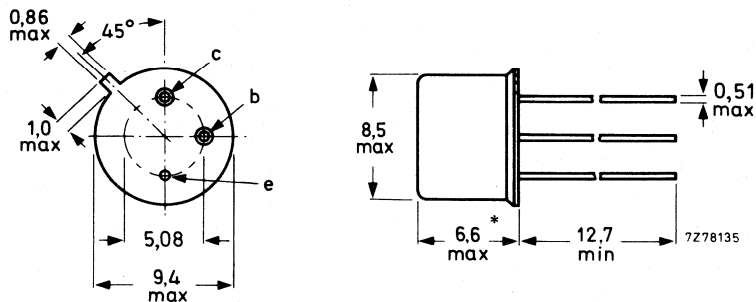
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w. class-B	13,5	175	4	> 12	> 55	$3,2 + j0,03$	$53 - j29$
c.w. class-B	12,5	175	4	typ. 12	typ. 60	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-39; emitter connected to case.



Maximum lead diameter is guaranteed only for 12,7 mm.

\* Max. 4,9 for BFQ43S.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	1,25 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	3,75 A
Total power dissipation up to $T_{mb} = 25$ °C	$P_{tot}$	max.	12 W
Storage temperature	$T_{stg}$		-65 to + 175 °C
Operating junction temperature	$T_j$	max.	200 °C

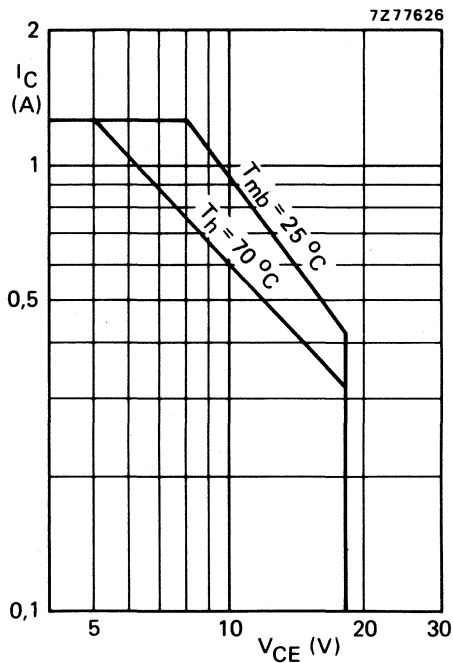
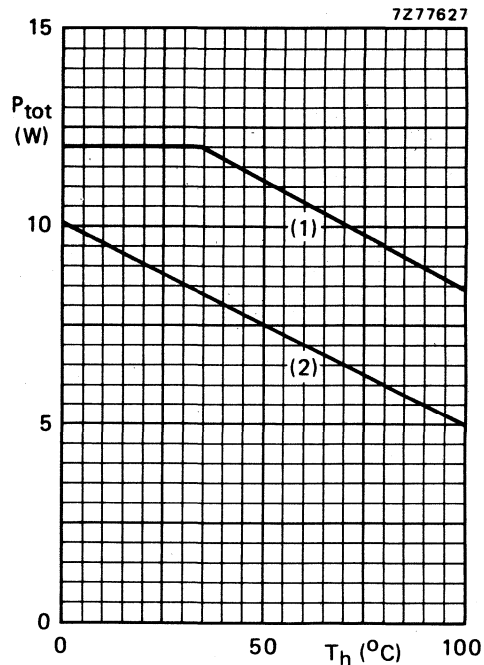


Fig. 2 D.C. SOAR.



- (1) Short-time r.f. operation during mismatch;  $f \geq 1$  MHz.
- (2) Continuous d.c. and r.f. operation; derate by 0,05 W/°C.

Fig. 3 Total power dissipation;  $V_{CE} \leq 16,5$  V.

**THERMAL RESISTANCE** (dissipation = 4 W;  $T_{mb} = 82$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base	$R_{th\ j-mb}$	=	18 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	3 K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 5\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 2\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 2\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\ \Omega$  $E_{SBO} > 0,5\text{ mJ}$  $E_{SBR} > 0,5\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,5\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 80

Collector-emitter saturation voltage \*

 $I_C = 1,5\text{ A}; I_B = 0,3\text{ A}$  $V_{CEsat}$  typ. 0,9 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 0,5\text{ A}; V_{CB} = 13,5\text{ V}$  $-I_E = 1,5\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 750 MHz $f_T$  typ. 625 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 13,5\text{ V}$  $C_C$  typ. 15 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 20\text{ mA}; V_{CE} = 13,5\text{ V}$  $C_{re}$  typ. 7,3 pF\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}; \delta \leq 0,02$ .

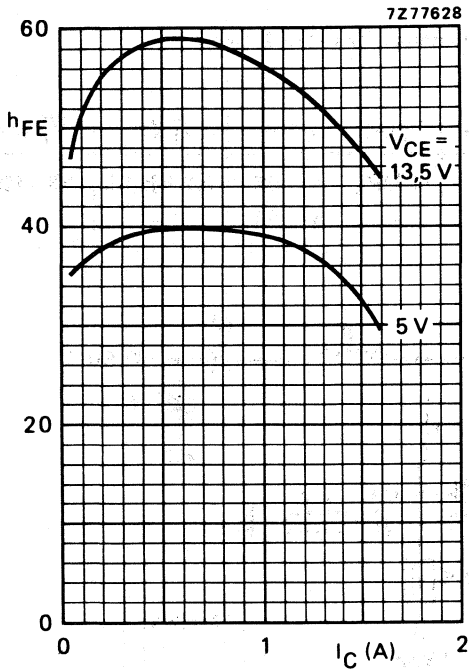


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

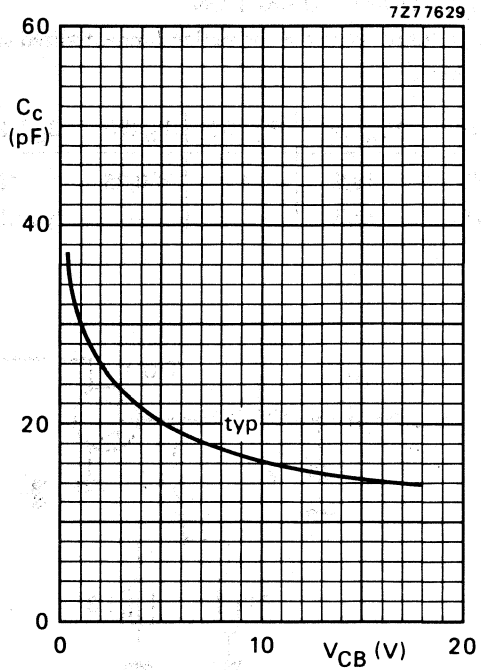


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

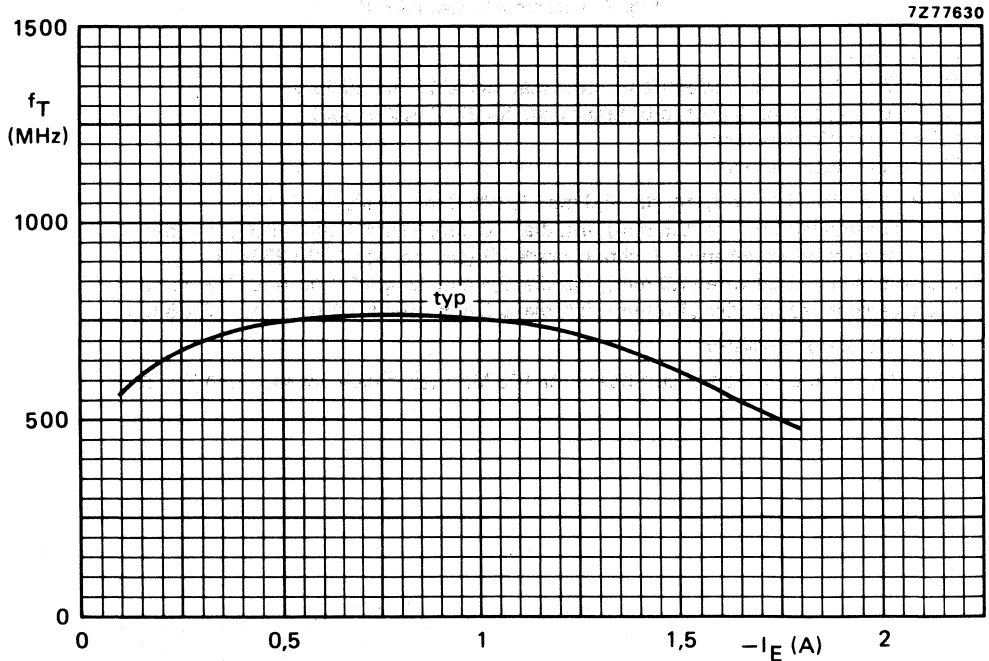


Fig. 6  $V_{CB} = 13,5\text{ V}$ ;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	13,5	4	< 0,25	> 12	< 0,54	> 55	$3,2 + j0,03$	$53 - j29$
175	12,5	4	—	typ. 12	—	typ. 60	—	—

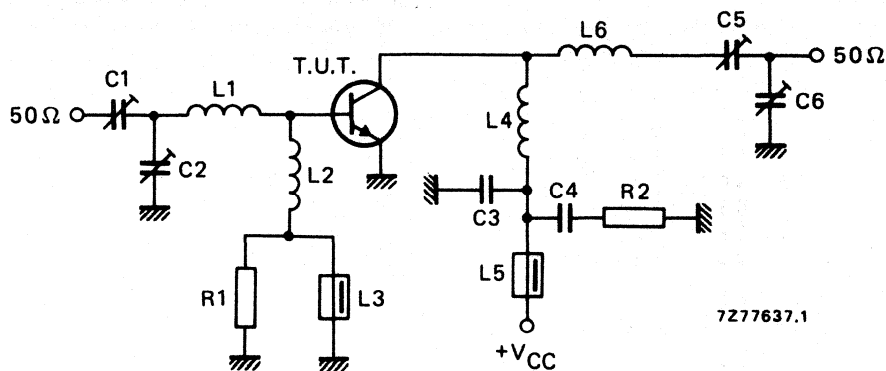


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = C5 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 100 pF ceramic capacitor

C4 = 100 nF polyester capacitor

L1 = 2 turns Cu wire (1,0 mm); int. dia. 4,0 mm; length 3 mm; leads 2 x 5 mm

L2 = 7 turns enamelled Cu wire (0,5 mm); int. dia. 3,0 mm; length 4 mm; leads 2 x 5 mm

L3 = L5 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = 4 turns enamelled Cu wire (1,0 mm); int. dia. 5,5 mm; length 5 mm; leads 2 x 5 mm

L6 = 5 turns enamelled Cu wire (1,0 mm); int. dia. 5,5 mm; length 7,5 mm; leads 2 x 5 mm

R1 = R2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit are shown in Fig. 8.

APPLICATION INFORMATION (continued)

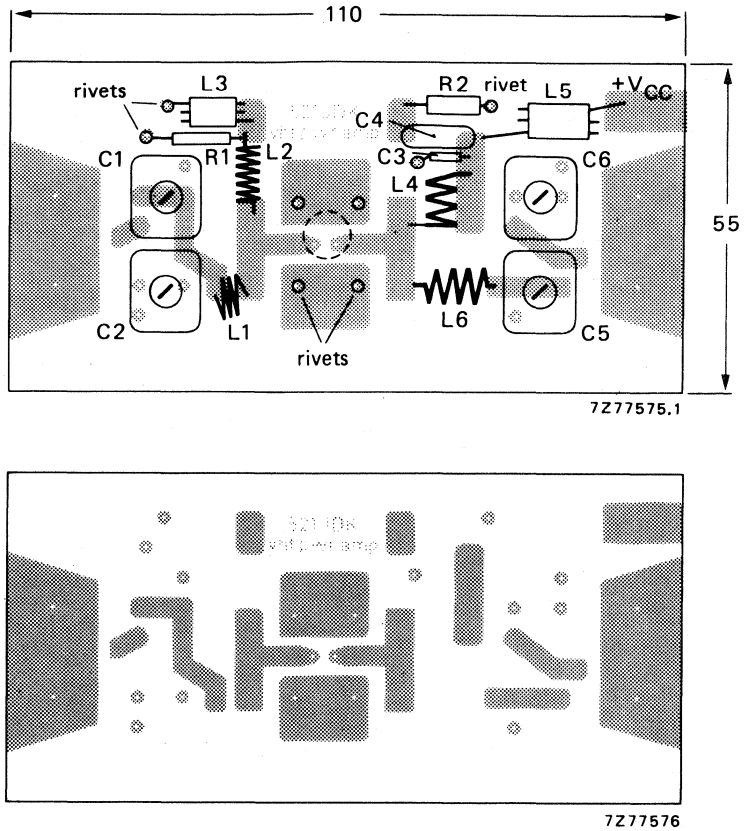


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.

Material of printed-circuit board: 1,6 mm epoxy fibre-glass.

The case is directly grounded on the printed-circuit board.

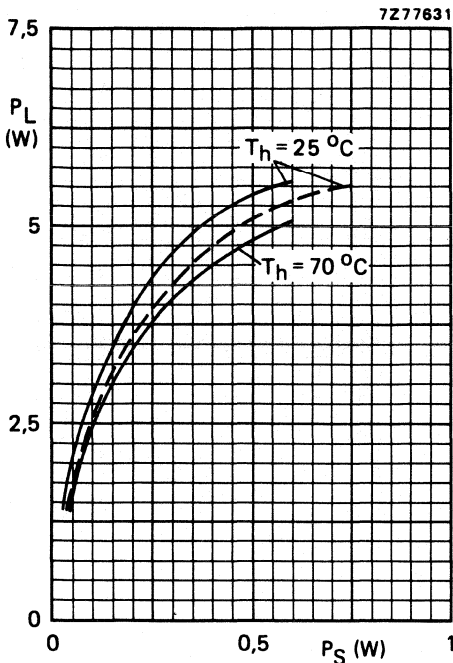


Fig. 9 Typical values;  $f = 175 \text{ MHz}$ ;  
—  $V_{CE} = 13,5 \text{ V}$ ; - - -  $V_{CE} = 12,5 \text{ V}$ .

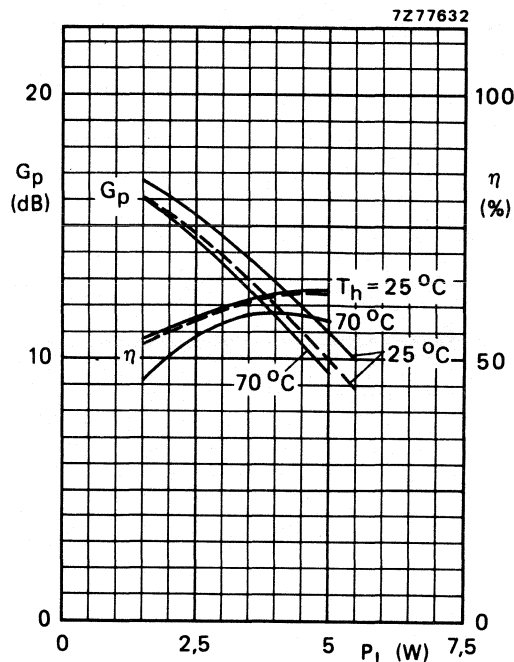


Fig. 10 Typical values;  $f = 175 \text{ MHz}$ ;  
—  $V_{CE} = 13,5 \text{ V}$ ; - - -  $V_{CE} = 12,5 \text{ V}$ .

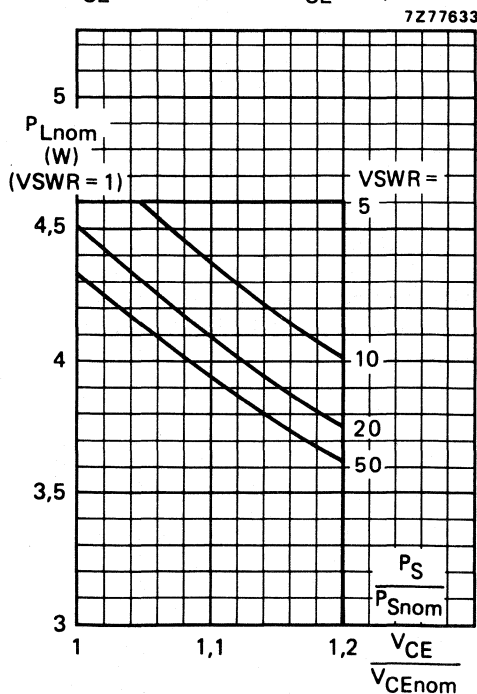


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ .  
 $R_{th \text{ mb-h}} = 3 \text{ K/W}$ ;  $V_{CE \text{ nom}} = 13,5 \text{ or } 12,5 \text{ V}$ ;  
 $P_S = P_{S \text{ nom}}$  at  $V_{CE \text{ nom}}$  and  $V_{SWR} = 1$ .

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $V_{SWR} = 1$ ), as a function of the expected supply over-voltage ratio with  $V_{SWR}$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{S \text{ nom}}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 140 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

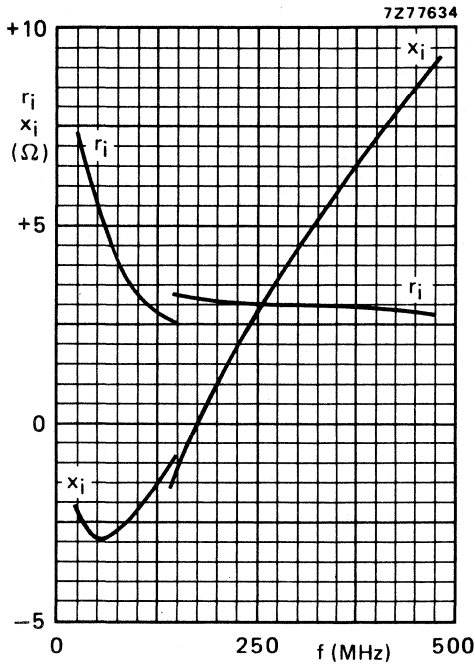


Fig. 12.

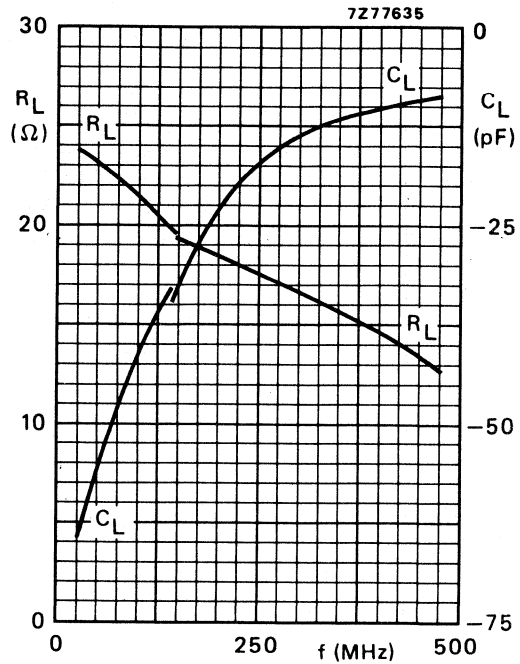
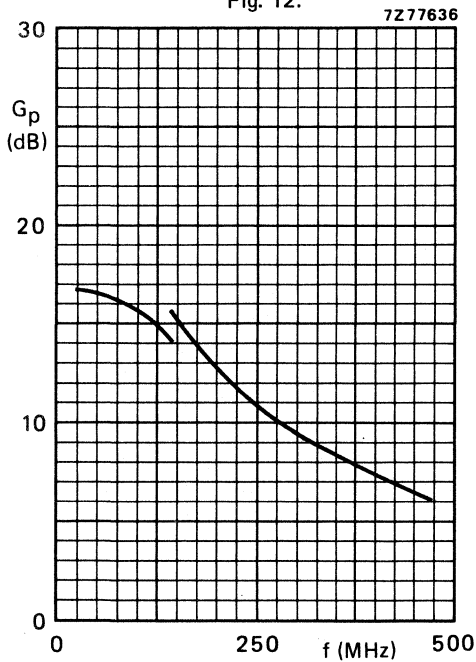


Fig. 13.



Conditions for Figs 12, 13 and 14:  
Typical values;  $V_{CE} = 13,5\text{ V}$ ;  $P_L = 4\text{ W}$ ;  
 $T_h = 25\text{ }^\circ\text{C}$ .

Fig. 14.

## V.H.F. POWER TRANSISTOR

N-P-N epitaxial planar transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 13,5 V. The transistor is resistance stabilized. Every transistor is tested under severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a TO-39 metal envelope with the collector connected to the case.

### QUICK REFERENCE DATA

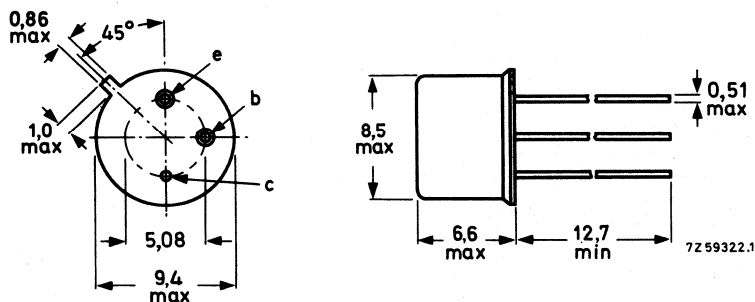
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	4	> 8	> 60	$3,9 + j2,2$	$37 - j22$
c.w.	12,5	175	4	typ. 8	typ. 60	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-39; collector connected to case.

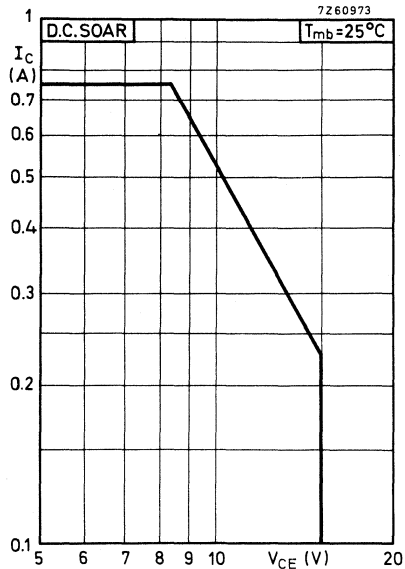
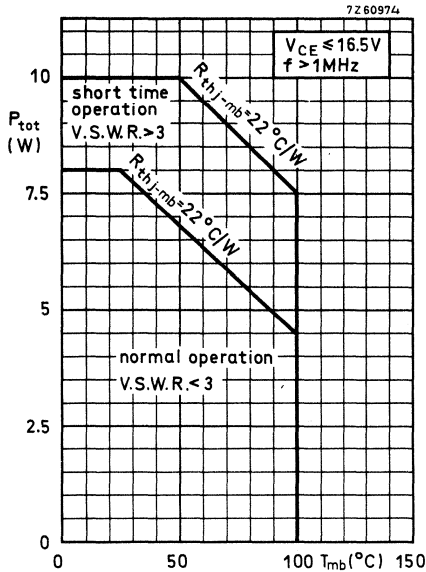


Maximum lead diameter is guaranteed only for 12,7 mm.

Accessories: 56245 (distance disc).

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4	V
Collector current (average)	$I_C(AV)$	max.	0.75	A
Collector current (peak value) $f > 1\text{MHz}$	$I_{CM}$	max.	2.25	A
Total power dissipation up to $T_{mb} = 25^\circ\text{C}$ $f > 1\text{MHz}$	$P_{tot}$	max.	8	W



Storage temperature	$T_{stg}$	-65 to +200	$^\circ\text{C}$
Operating junction temperature	$T_j$	max. 200	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	22	K/W
From mounting base to heatsink with a boron nitride washer for electrical insulation	$R_{th\ mb-h}$	=	2.5	K/W



## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

## Collector cut-off current

$I_B = 0; V_{CE} = 14\text{ V}$   $I_{CEO} < 5\text{ mA}$

## Breakdown voltages

Collector-base voltage  
open emitter,  $I_C = 1\text{ mA}$

$V_{(BR)CBO} > 36\text{ V}$

Collector-emitter voltage  
open base,  $I_C = 10\text{ mA}$

$V_{(BR)CEO} > 18\text{ V}$

Emitter-base voltage  
open collector,  $I_E = 1\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

## Transient energy

$L = 25\text{ mH}; f = 50\text{ Hz}$

open base  $E > 0.5\text{ mS}$

$-V_{BE} = 1.5\text{ V}; R_{BE} = 33\ \Omega$   $E > 0.5\text{ mS}$

## D. C. current gain

$I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$   $h_{FE} > 5$

## Transition frequency

$I_C = 350\text{ mA}; V_{CE} = 10\text{ V}$   $f_T$  typ. 700 MHz

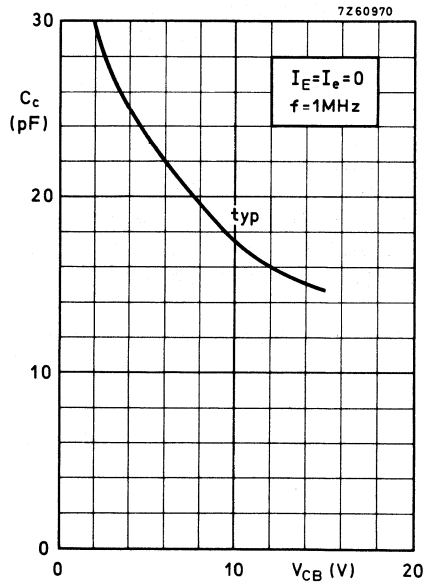
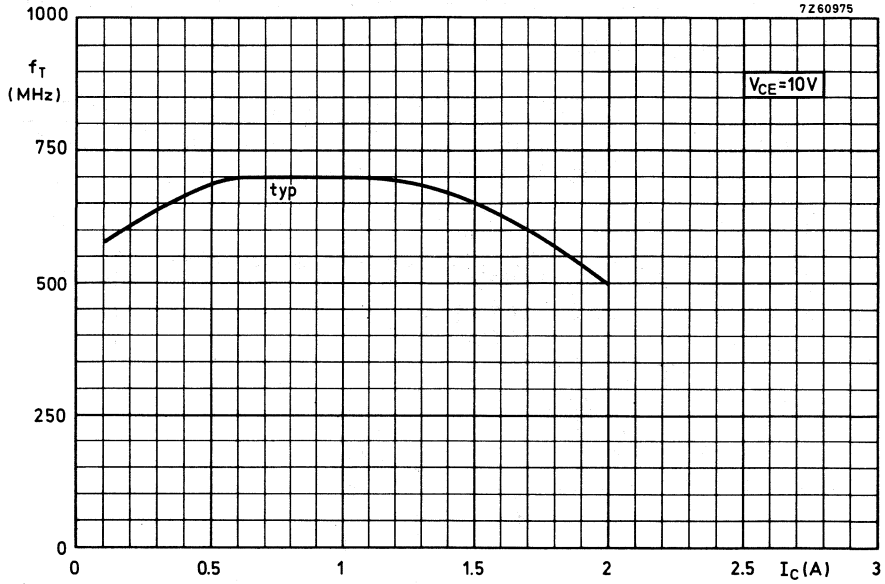
Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0; V_{CB} = 15\text{ V}$   $C_c$  typ. 15 pF

< 20 pF

Feedback capacitance at  $f = 1\text{ MHz}$ 

$I_C = 50\text{ mA}; V_{CE} = 15\text{ V}$   $-C_{re}$  typ. 11 pF



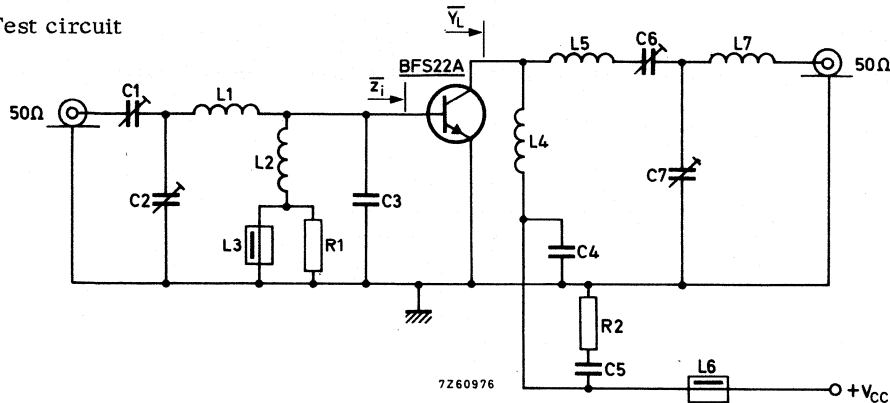
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

 $f = 175 \text{ MHz}$ ;  $T_{mb}$  up to  $25 \text{ }^\circ\text{C}$ 

$V_{CC}(V)$	$P_S(W)$	$P_L(W)$	$I_C(A)$	$G_p(dB)$	$\eta(\%)$	$\bar{z}_i(\Omega)$	$\bar{V}_L(mS)$
13.5	< 0.63	4	< 0.49	> 8	> 60	$3.9 + j2.2$	$37 - j22$
12.5	typ. 0.63	4	typ. 0.53	typ. 8	typ. 60	-	-

Test circuit



C1 = C6 = 4 to 29 pF air trimmer with insulated rotor

C2 = C7 = 4 to 29 pF air trimmer with non-insulated rotor

C3 = 39 pF ceramic

C4 = 100 pF ceramic

C5 = 15 nF polyester

L1 = 1 turn enamelled Cu wire (1.0 mm); int. diam. 10 mm; leads 2 x 10 mm

L2 = 6 turns enamelled Cu wire (0.7 mm); int. diam. 4 mm; leads 2 x 10 mm

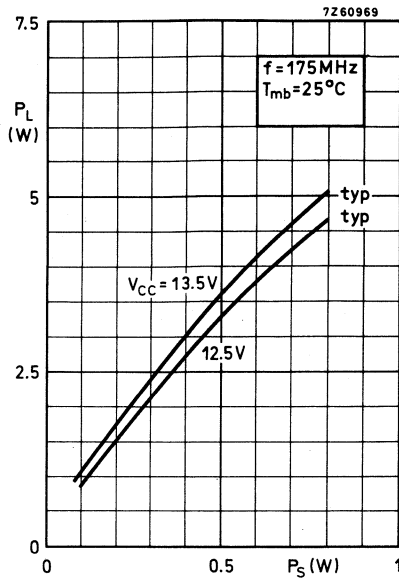
L3 = L6 = ferroxcube choke (code number 4312 020 36640)

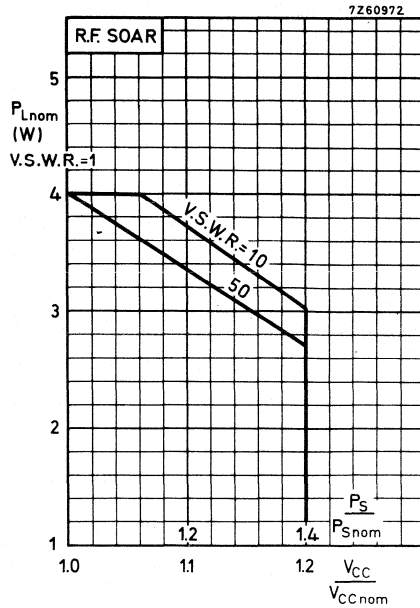
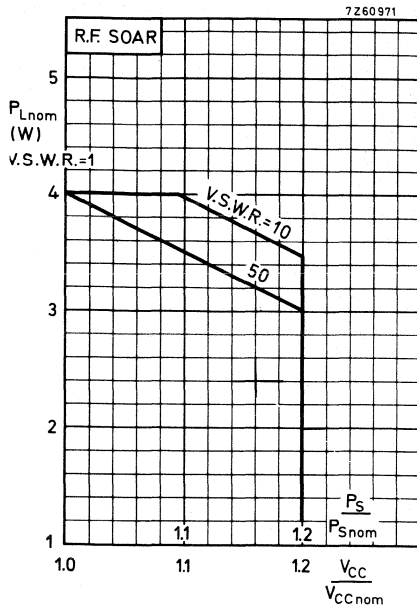
L4 = 8 turns enamelled Cu wire (0.7 mm); int. diam. 4 mm; leads 2 x 10 mm

L5 = 5 turns enamelled Cu wire (1.0 mm); winding pitch 1.0 mm; int. diam. 8 mm; leads 2 x 10 mm

L7 = 7 turns enamelled Cu wire (1.0 mm); winding pitch 1.0 mm; int. diam. 6 mm; leads 2 x 5 mm

R1 = R2 = 10  $\Omega$  carbon





Conditions for R.F. SOAR:

- $f = 175 \text{ MHz}$        $P_{Snom} = P_S$  at  $V_{CC} = V_{CCnom}$  and  $V.S.W.S. = 1$
- $T_{mb} = 70^\circ \text{C}$
- $V_{CCnom} = 12.5 \text{ or } 13.5 \text{ V}$

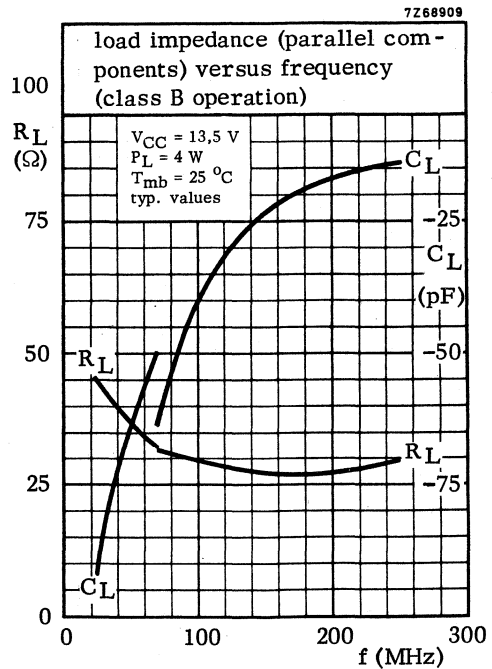
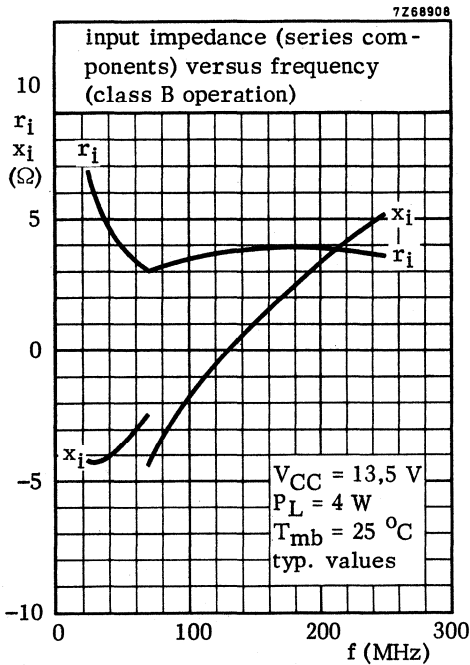
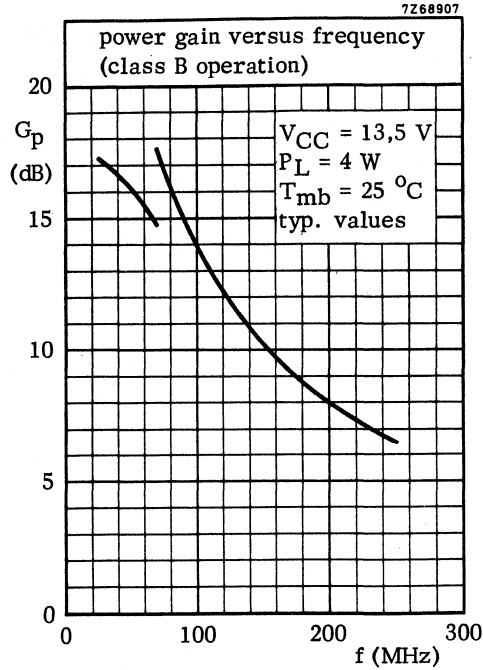
The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graphs above for safe operation at supply voltages other than the nominal. The graphs show the allowable output power under nominal conditions, as a function of the supply overvoltage ratio, with V. S. W. R. as parameter.

The left hand graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply overvoltage ratio.

The right hand graph shows the derating factor to be applied when the drive ( $P_S/P_{Snom}$ ) increases as the square of the supply overvoltage ratio ( $V_{CC}/V_{CCnom}$ ).

Depending on the operating conditions, the appropriate derating factor may lie in the region between the linear and the square-law functions.

**OPERATING NOTE** Below 70 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.



## V.H.F. POWER TRANSISTOR

N-P-N epitaxial planar transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 28 V. The transistor is resistance stabilized. Every transistor is tested under severe load mismatch conditions.

It has a TO-39 metal envelope with the collector connected to the case.

### QUICK REFERENCE DATA

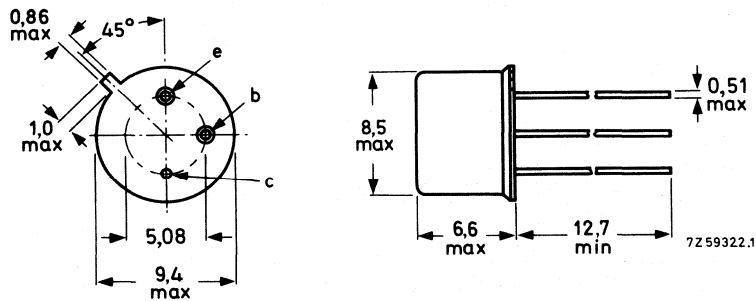
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	4	> 10	> 65	$2,3 + j1,6$	$8,9 - j18,1$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-39; collector connected to case.

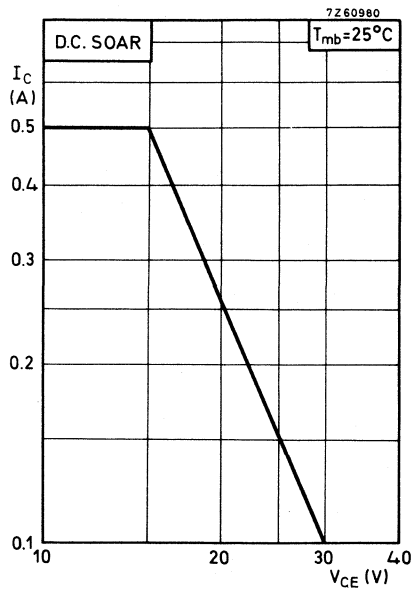
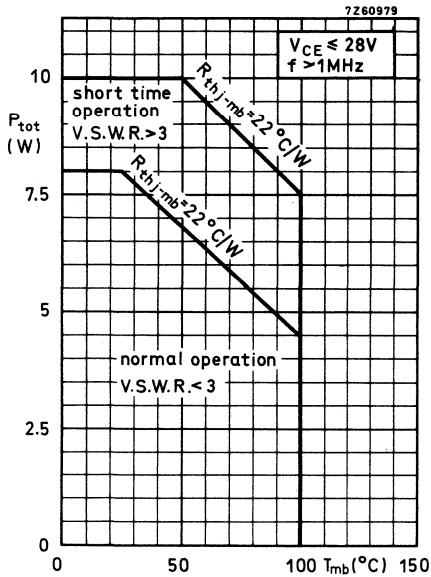


Maximum lead diameter is guaranteed only for 12,7 mm.

Accessories: 56245 (distance disc).

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$ max.	65	V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	36	V
Emitter-base voltage (open collector)	$V_{EBO}$ max.	4	V
Collector current (average)	$I_{C(AV)}$ max.	0.5	A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$ max.	1.5	A
Total power dissipation up to $T_{mb} = 25$ °C $f > 1$ MHz	$P_{tot}$ max.	8	W



Storage temperature	$T_{stg}$	-65 to +200	°C
Operating junction temperature	$T_j$	max. 200	°C

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	22	K/W
From mounting base to heatsink with a boron nitride washer for electrical insulation	$R_{th\ mb-h}$	=	2.5	K/W



## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_B = 0; V_{CE} = 28 \text{ V} \quad I_{CEO} < 5 \text{ mA}$$

Breakdown voltages

Collector-base voltage  
open emitter,  $I_C = 1 \text{ mA}$

$$V_{(BR)CBO} > 65 \text{ V}$$

Collector-emitter voltage  
open base,  $I_C = 10 \text{ mA}$

$$V_{(BR)CEO} > 36 \text{ V}$$

Emitter-base voltage  
open collector;  $I_E = 1 \text{ mA}$

$$V_{(BR)EBO} > 4 \text{ V}$$

Transient energy

$L = 25 \text{ mH}; f = 50 \text{ Hz}$

$$\begin{array}{ll} \text{open base} & E > 0.5 \text{ ms} \\ -V_{BE} = 1.5 \text{ V}; R_{BE} = 33 \Omega & E > 0.5 \text{ ms} \end{array}$$

D.C. current gain

$$I_C = 500 \text{ mA}; V_{CE} = 5 \text{ V} \quad h_{FE} > 5$$

Transition frequency

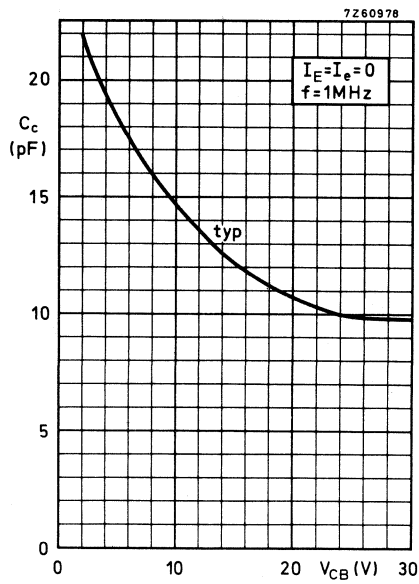
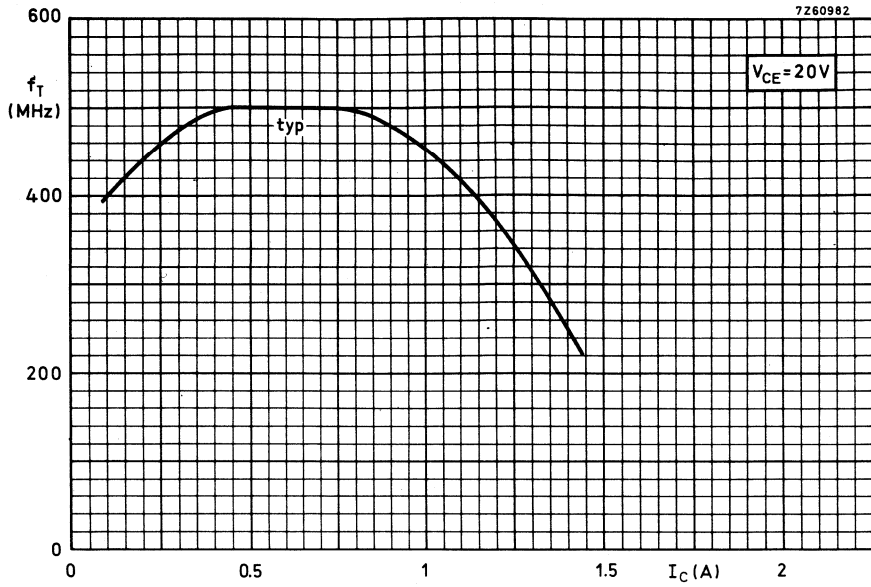
$$I_C = 400 \text{ mA}; V_{CE} = 20 \text{ V} \quad f_T \text{ typ. } 500 \text{ MHz}$$

Collector capacitance at  $f = 1 \text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 30 \text{ V} \quad C_c \begin{array}{l} \text{typ. } 10 \text{ pF} \\ < 15 \text{ pF} \end{array}$$

Feedback capacitance at  $f = 1 \text{ MHz}$

$$I_C = 25 \text{ mA}; V_{CE} = 30 \text{ V} \quad -C_{re} \text{ typ. } 7.5 \text{ pF}$$



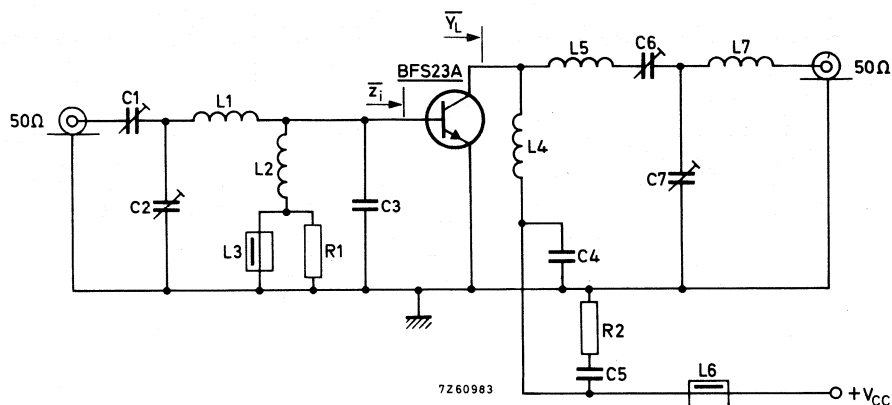
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

$$V_{CC} = 28 \text{ V}; T_{mb} \text{ up to } 25 \text{ }^{\circ}\text{C}$$

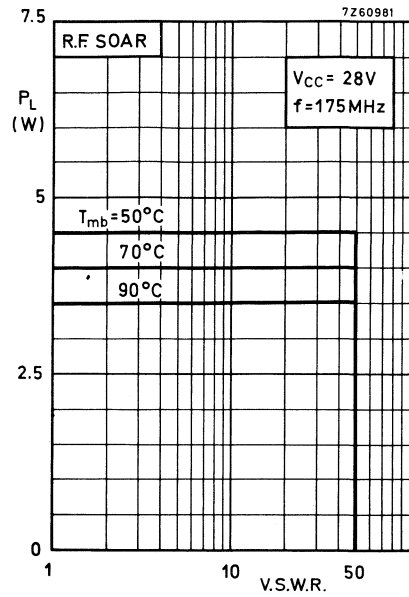
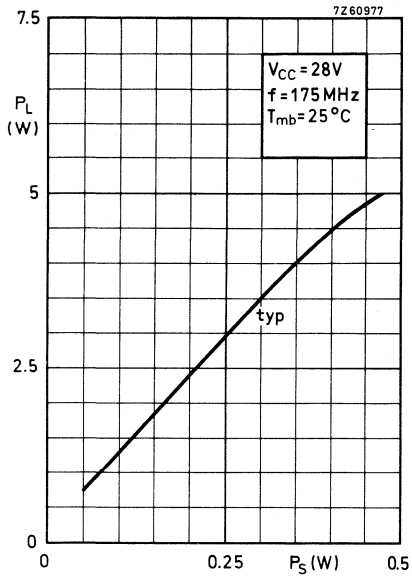
f(MHz)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{V}_L$ (mS)
175	< 0.40	4	< 0.22	> 10	> 65	$2.3+j1.6$	8.9 - j18.1

Test circuit



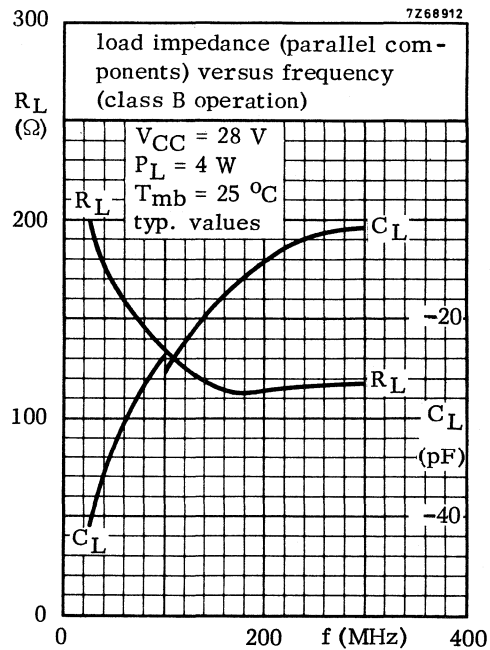
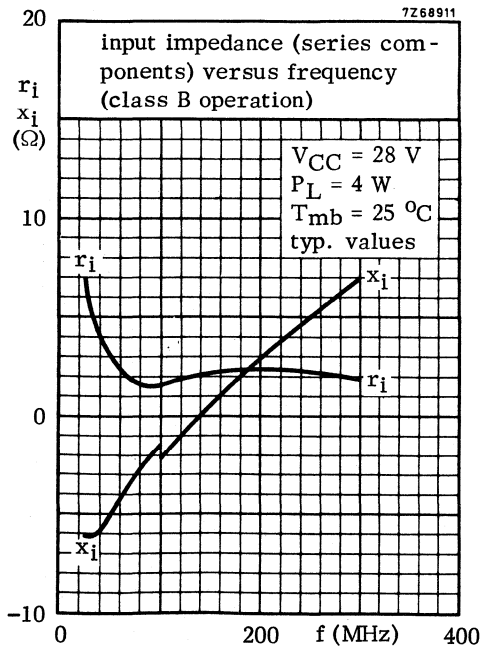
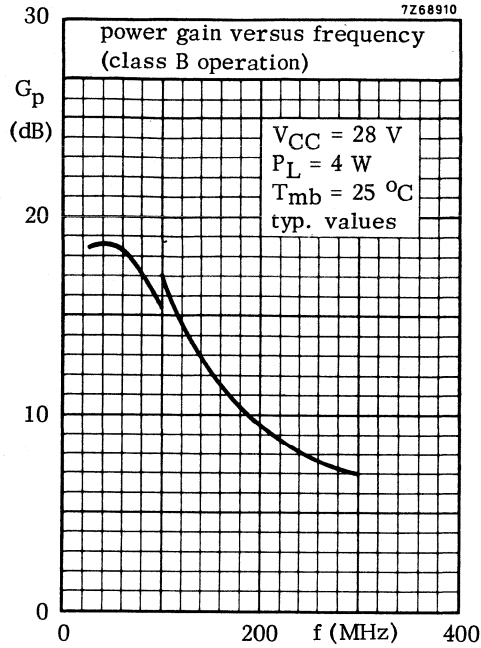
- $C1 = C6 = 4$  to 29 pF air trimmer with insulated rotor  
 $C2 = C7 = 4$  to 29 pF air trimmer with non-insulated rotor  
 $C3 = 39$  pF ceramic  
 $C4 = 100$  pF ceramic  
 $C5 = 15$  nF polyester

- $L1 = 1$  turn enamelled Cu wire (1.0 mm); int. diam. 10 mm; leads 2 x 10 mm  
 $L2 = 6$  turns enamelled Cu wire (0.7 mm); int. diam. 4 mm; leads 2 x 10 mm  
 $L3 = L6 =$  ferroxcube choke (code number 4312 020 36640)  
 $L4 = 8$  turns enamelled Cu wire (0.7 mm); int. diam. 4 mm; leads 2 x 10 mm  
 $L5 = 5$  turns enamelled Cu wire (1.0 mm); winding pitch 1.0 mm; int. diam. 8 mm; leads 2 x 10 mm  
 $L7 = 4$  turns enamelled Cu wire (1.0 mm); winding pitch 1.0 mm; int. diam. 6 mm; leads 2 x 5 mm  
 $R1 = R2 = 10 \Omega$  carbon



For high voltage operation, a stabilized power supply is generally used. The graph shows the allowable output power under nominal conditions as a function of the V.S.W.R., with heat-sink temperature as parameter.

**OPERATING NOTE** Below 100 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





Data sheet	
<b>status</b>	Preliminary specification
<b>date of issue</b>	October 1990

# BLT50

## UHF power transistor

### DESCRIPTION

NPN silicon planar epitaxial transistor, designed primarily for use in hand-held radio equipment in the 470 MHz communications band. The transistor is encapsulated in a surface-mounted envelope (SOT223).

### QUICK REFERENCE DATA

RF performance at  $T_{\text{coll.tab}} = 125 \text{ }^\circ\text{C}$  in a common emitter class-B test circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>P</sub> (dB)	$\eta_c$ (%)
c.w. narrow band	470	7.5	1.2	> 10.5	> 55

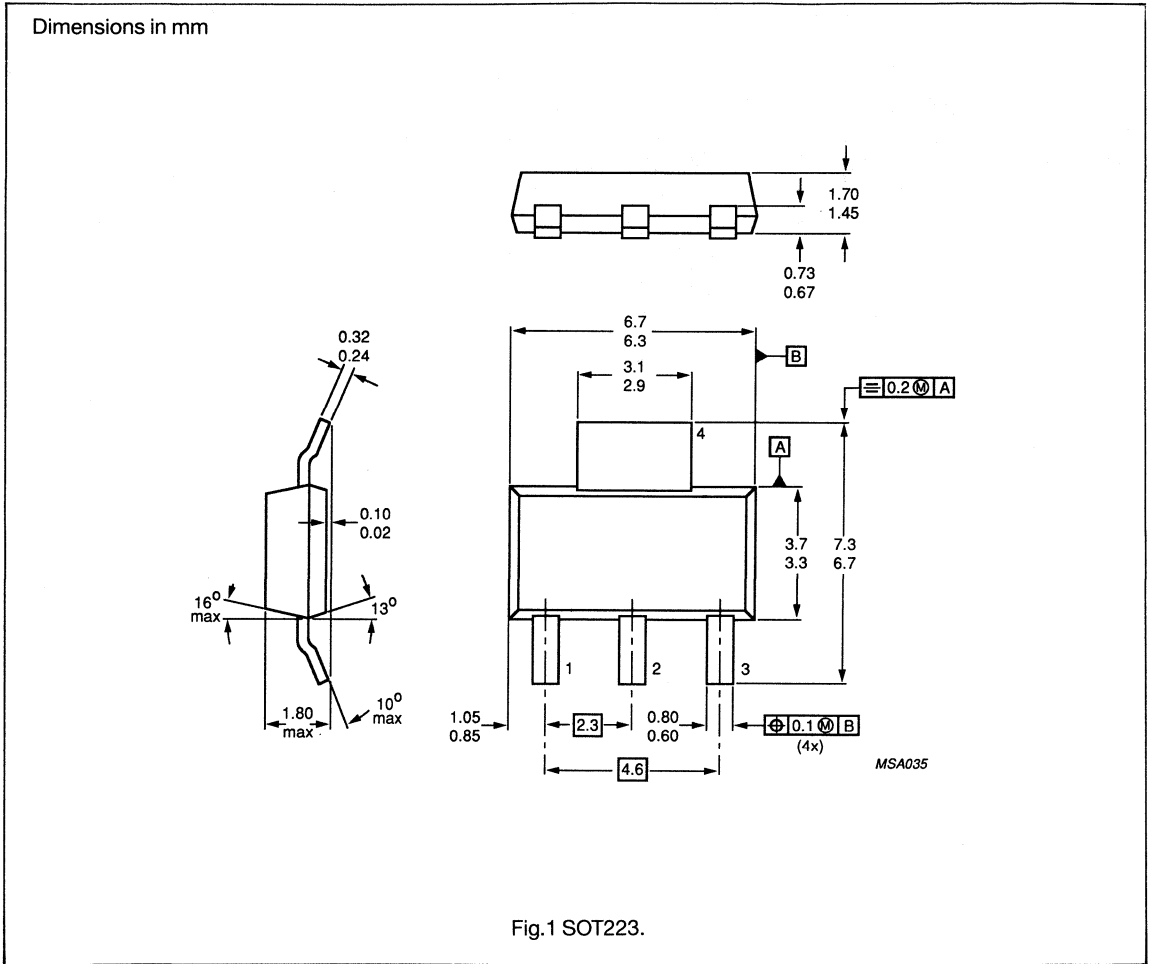
### MECHANICAL DATA

SOT223 - see Fig. 1

# UHF power transistor

# BLT50

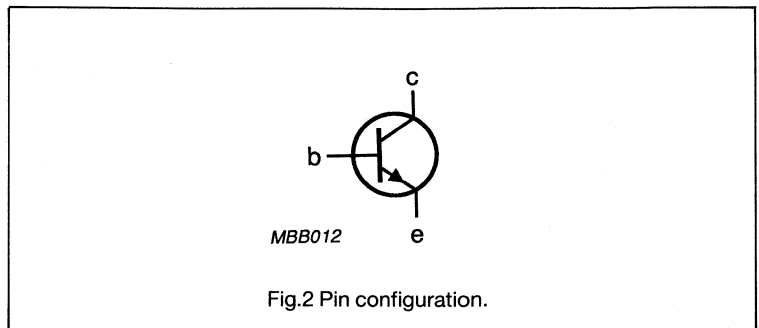
## MECHANICAL DATA



### PINNING

PIN	DESCRIPTION
1	emitter
2	base
3	emitter
4	collector

### PIN CONFIGURATION





# UHF power transistor

# BLT50

## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	-	20	V
$V_{CEO}$	collector-emitter voltage	open base	-	10	V
$V_{EBO}$	emitter-base voltage	open collector	-	3	V
$I_C$	collector current	DC or average	-	0.5	A
$I_{CM}$	collector current	peak value $f > 1$ MHz	-	1.5	A
$P_{tot}$	total power dissipation	$T_{coll.tab} = 125$ °C	-	2	W
$T_{stg}$	storage temperature range		-65	150	°C
$T_j$	operating junction temperature		-	175	°C

## THERMAL RESISTANCE

SYMBOL	PARAMETER	MAX.	UNIT
$R_{th\ j-tab(DC)}$	from junction to collector-tab	25	K/W

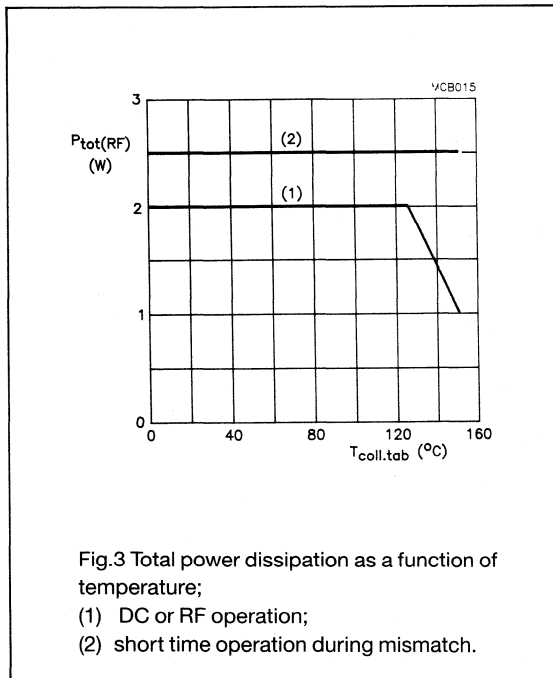


Fig.3 Total power dissipation as a function of temperature;  
 (1) DC or RF operation;  
 (2) short time operation during mismatch.

**UHF power transistor****BLT50****CHARACTERISTICS**at  $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter $I_C = 2.5\text{ mA}$	20	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base $I_C = 5\text{ mA}$	10	-	-	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector $I_E = 0.5\text{ mA}$	3	-	-	V
$I_{CES}$	collector-emitter cut-off current	$V_{BE} = 0$ $V_{CE} = 10\text{ V}$	-	-	2.5	mA
$h_{FE}$	DC current gain	$V_{CE} = 5\text{ V}$ $I_C = 300\text{ mA}$	25	-	-	
$C_c$	collector capacitance	$V_{CB} = 7.5\text{ V}$ $I_E = I_e = 0$ $f = 1\text{ MHz}$	-	4.5	6	pF
$C_{re}$	feedback capacitance	$V_{CE} = 7.5\text{ V}$ $I_C = 0$ $f = 1\text{ MHz}$	-	4.5	3	pF

**APPLICATION INFORMATION**RF performance at  $T_{coll.tab} = 125\text{ }^\circ\text{C}$  in a common emitter class-B test circuit.

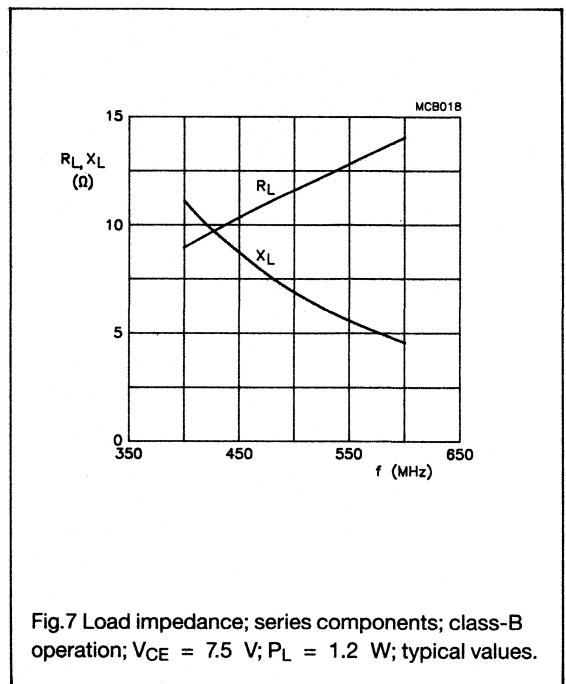
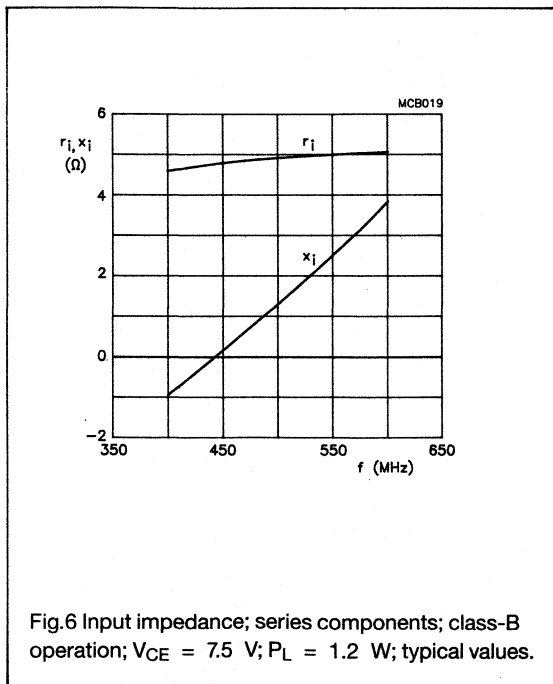
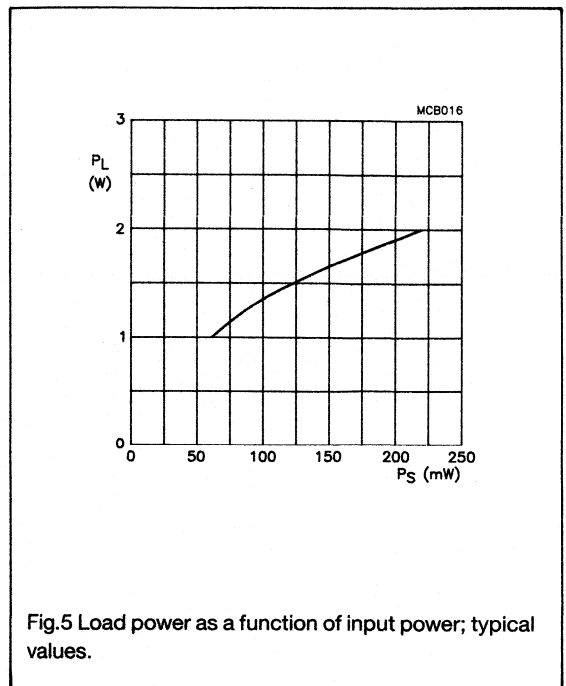
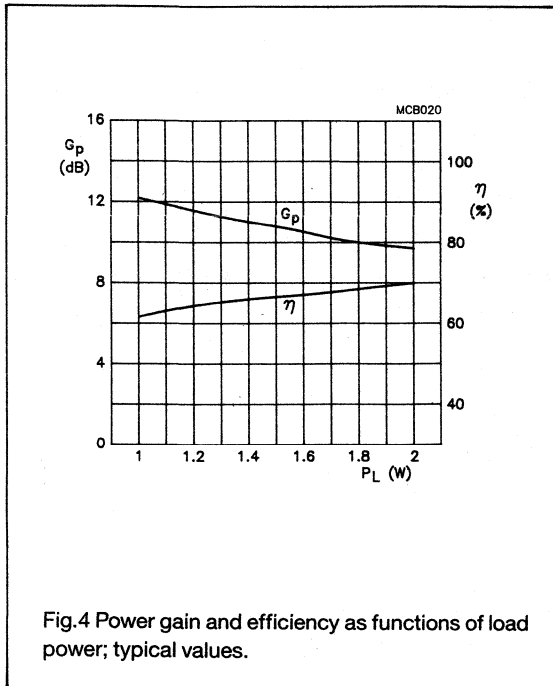
MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$G_P$ (dB)	$\eta_C$ (%)
c.w. narrow band	470	7.5	1.2	> 10.5 typ. 11.5	> 55 typ. 65

**Ruggedness in class-B operation**

The BLT50 is capable of withstanding a load mismatch corresponding to  $V_{SWR} = 50$  through all phases, at rated output power up to a supply voltage of 9 V,  $f = 470\text{ MHz}$  and  $T_{coll.tab} = 125\text{ }^\circ\text{C}$ .

# UHF power transistor

# BLT50



UHF power transistor

BLT50

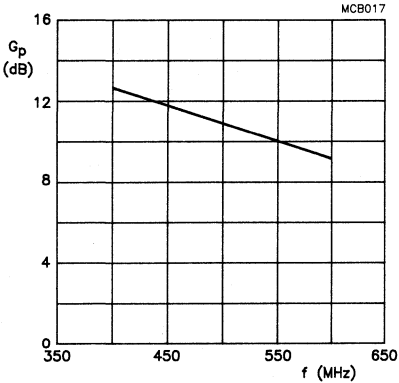


Fig.8 Power gain; class-B operation;  $V_{CE} = 7.5$  V;  $P_L = 1.2$  W; typical values.

Data sheet	
status	Preliminary specification
date of issue	October 1990

# BLT80

## UHF power transistor

### DESCRIPTION

NPN silicon planar epitaxial transistor, designed primarily for use in hand-held radio equipment in the 900 MHz communications band. The transistor is encapsulated in a surface-mounted envelope (SOT223).

### QUICK REFERENCE DATA

RF performance at  $T_{amb} = 25\text{ }^{\circ}\text{C}$  in a common emitter class-B test circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
c.w. narrow band	900	7.5	0.8	> 6	> 60

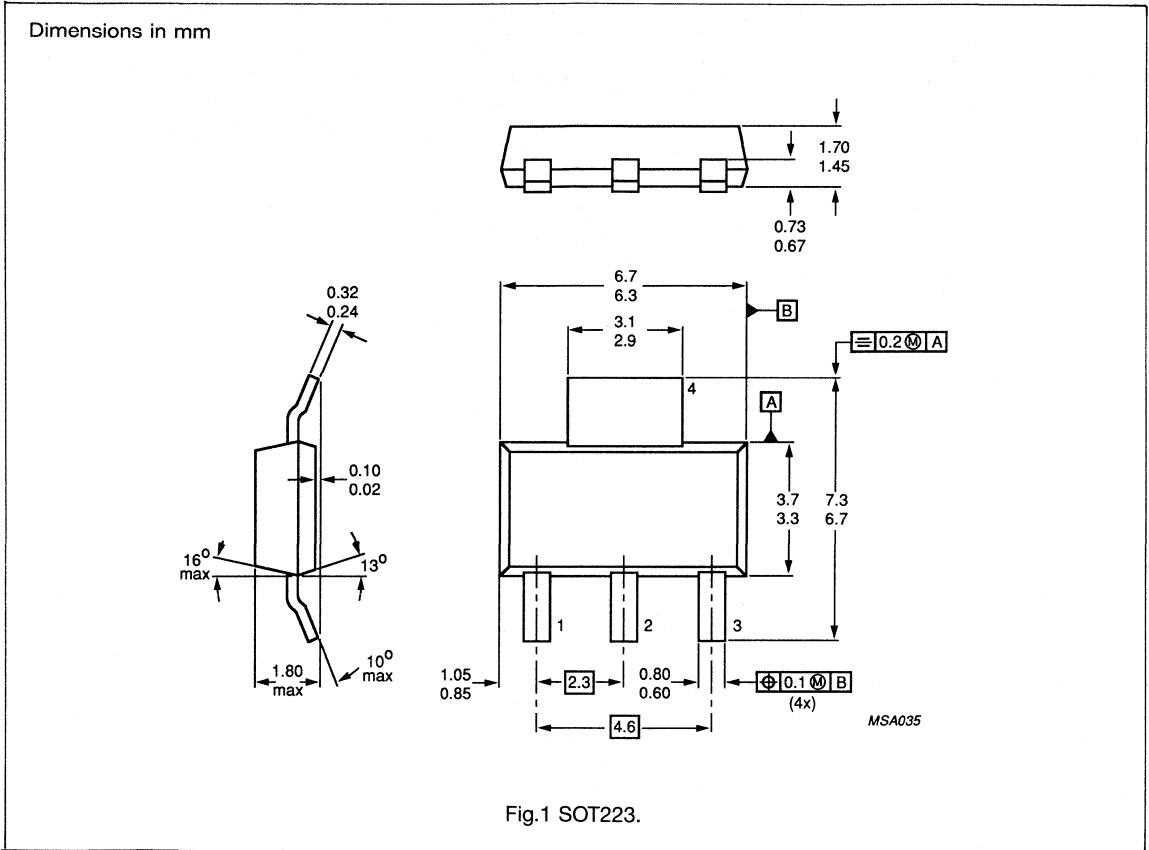
### MECHANICAL DATA

SOT223 - see Fig.1

# UHF power transistor

# BLT80

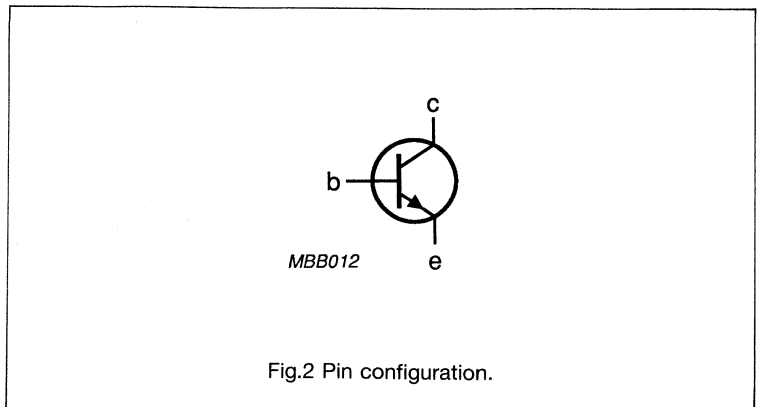
## MECHANICAL DATA



### PINNING

PIN	DESCRIPTION
1	emitter
2	base
3	emitter
4	collector

### PIN CONFIGURATION



## UHF power transistor

BLT80

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	-	20	V
$V_{CEO}$	collector-emitter voltage	open base	-	10	V
$V_{EBO}$	emitter-base voltage	open collector	-	3	V
$I_C, I_{C(av)}$	collector current	DC or average	-	250	mA
$I_{CM}$	collector current	peak value $f > 1$ MHz	-	750	mA
$P_{tot}$	total power dissipation	$T_{coll,tab} = 135$ °C $f > 1$ MHz	-	2	W
$T_{stg}$	storage temperature range		-65	150	°C
$T_j$	operating junction temperature		-	175	°C

## THERMAL RESISTANCE

SYMBOL	PARAMETER	MAX.	UNIT
$R_{th\ j-tab(DC)}$	from junction to collector-tab	20	K/W

## CHARACTERISTICS

at  $T_j = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)\ CBO}$	collector-base breakdown voltage	open emitter $I_C = 2.5$ mA	20	-	-	V
$V_{(BR)\ CEO}$	collector-emitter breakdown voltage	open base $I_C = 5$ mA	10	-	-	V
$V_{(BR)\ EBO}$	emitter-base breakdown voltage	open collector $I_E = 0.5$ mA	3	-	-	V
$I_{CES}$	collector-emitter cut-off current	$V_{BE} = 0$ $V_{CE} = 10$ V	-	-	1	mA
$h_{FE}$	DC current gain	$V_{CE} = 5$ V $I_C = 150$ mA	25	-	-	
$C_c$	collector capacitance	$V_{CB} = 7.5$ V $I_E = I_e = 0$ $f = 1$ MHz	-	-	3.5	pF
$C_{re}$	feedback capacitance	$V_{CE} = 7.5$ V $I_C = 0$ $f = 1$ MHz	-	-	2.5	pF

## APPLICATION INFORMATION

RF performance at  $T_{coll,tab} = 135$  °C in a common emitter class-B test circuit.

MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$G_p$ (dB)	$\eta_C$ (%)
c.w. narrow band	900	7.5	0.8	> 6 typ. 7.5	> 60 typ. 67

## UHF power transistor

BLT80

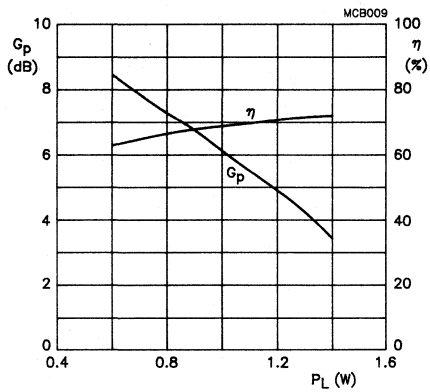


Fig.3 Power gain and efficiency as functions of load power; typical values.

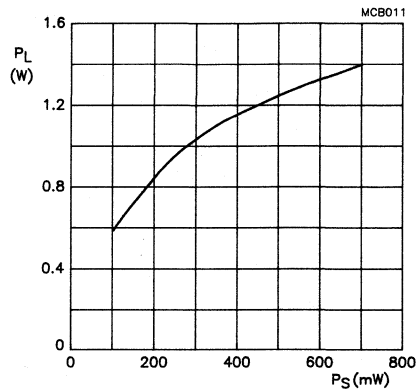


Fig.4 Load power as a function of input power; typical values.

### Ruggedness in class-B operation

The BLT80 is capable of withstanding a load mismatch corresponding to  $V_{SWR} = 50$  through all phases, at rated output power up to a supply voltage of 9 V,  $f = 900$  MHz and  $T_{coll.tab} = 135$  °C.



## UHF power transistor

BLT80

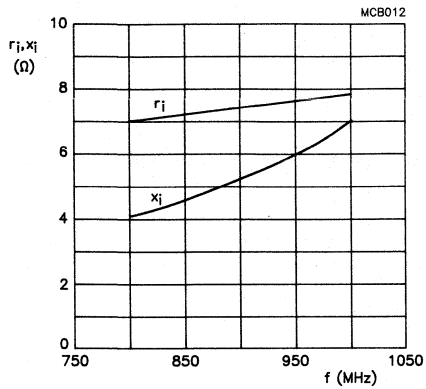


Fig.5 Input impedance; series components; class-B operation;  $V_{CE} = 7.5$  V;  $P_L = 0.8$  W; typical values.

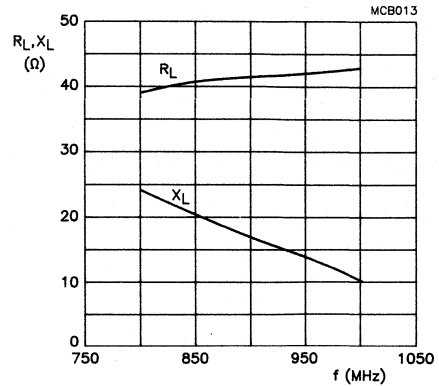


Fig.6 Load impedance; series components; class-B operation;  $V_{CE} = 7.5$  V;  $P_L = 0.8$  W; typical values.

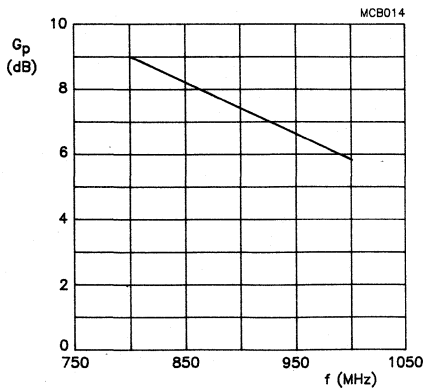


Fig.7 Power gain; class-B operation;  $V_{CE} = 7.5$  V;  $P_L = 0.8$  W; typical values.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in handheld radio stations in the 900 MHz communications band.

This device has been designed specifically for class-B operation.

### Features:

- the device can be applied at rated load power without an external heatsink when it is mounted on a printed circuit board (see Fig. 4).
- gold metallization ensures excellent reliability.

The transistor has a 4-lead studless envelope with a ceramic cap (SOT-172D). All leads are isolated from the mounting base.

### QUICK REFERENCE DATA

R.F. performance at  $T_a = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit.\*

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
c.w. (class-B)	7,5	900	0,75	> 7,0	> 50

\* Device mounted on a printed circuit board (see Fig. 4).

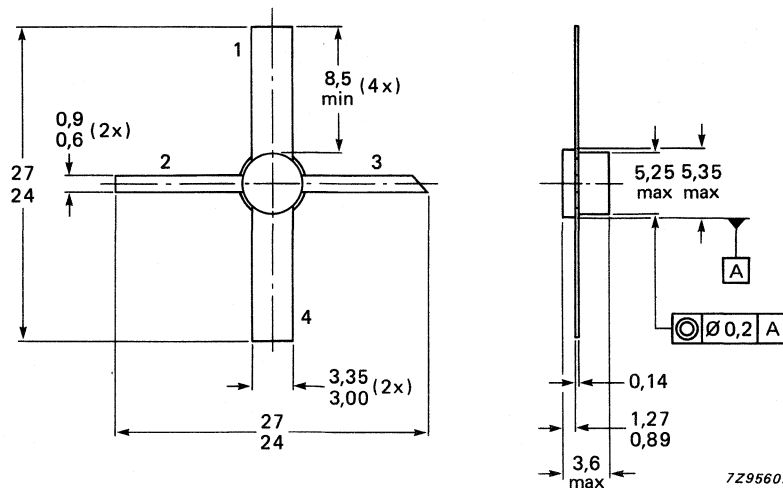
### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-172D.

#### Pinning:

- 1 Emitter
- 2 Base
- 3 Collector
- 4 Emitter



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	10 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
average	$I_C; I_{C(AV)}$	max.	250 mA
(peak value); $f > 1$ MHz	$I_{CM}$	max.	750 mA
Total power dissipation			
at $T_{amb} = 50$ °C; $f > 1$ MHz*	$P_{tot}(rf)$	max.	2,3 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

**THERMAL RESISTANCE**Dissipation = 2,5 W;  $T_{mb} = 25$  °C

From junction to ambient* ( $f > 1$ MHz)	$R_{th\ j-a}(rf)$	max.	65 K/W
From junction to mounting base ( $f > 1$ MHz)	$R_{th\ j-mb}(rf)$	max.	25 K/W

\* Device mounted on a printed circuit board (see Fig. 4).

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 2,5\text{ mA}$

$V_{(BR)CBO} > 20\text{ V}$

Collector-emitter breakdown voltage  
open base;  $I_C = 5\text{ mA}$

$V_{(BR)CEO} > 10\text{ V}$

Emitter-base breakdown voltage  
open collector;  $I_E = 0,5\text{ mA}$

$V_{(BR)EBO} > 3\text{ V}$

Collector cut-off current  
 $V_{BE} = 0; V_{CE} = 10\text{ V}$

$I_{CES} < 1\text{ mA}$

Second breakdown energy  
 $L = 25\text{ mH}; f = 50\text{ Hz}; R_{BE} = 10\text{ }\Omega$

$ESBR > 0,3\text{ mJ}$

D.C. current gain

$I_C = 0,15\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE} > 25$

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = i_e = 0; V_{CB} = 7,5\text{ V}$

$C_c$  typ.  $2,8\text{ pF}$

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 0; V_{CE} = 7,5\text{ V}$

$C_{re}$  typ.  $1,6\text{ pF}$

Collector-mounting base capacitance

$C_{c-mb}$  typ.  $0,5\text{ pF}$

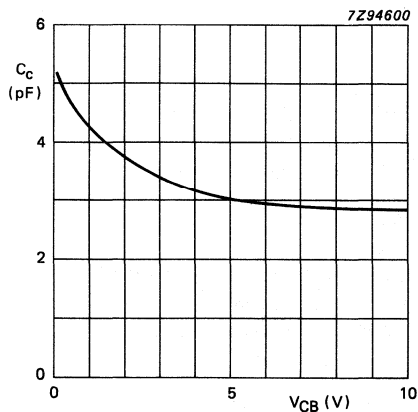
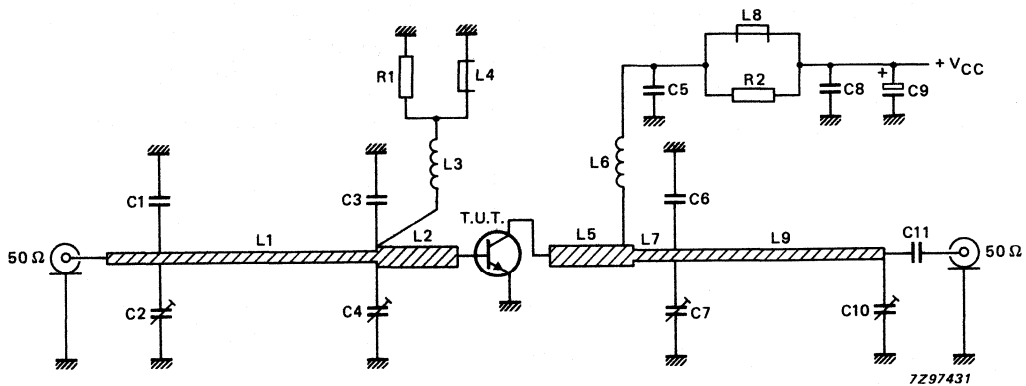


Fig. 2  $I_E = i_e = 0; f = 1\text{ MHz}$ ; typical values.

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class-B):  $f = 900 \text{ MHz}$ ;  $T_a = 25 \text{ }^\circ\text{C}$ 

mode of operation	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	7,5	0,75	>7,0 typ. 8,5	>50 typ. 63

Fig. 3 Class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components:

- C1 = 3 pF multilayer ceramic chip capacitor\*
- C2 = C4 = C7 = C10 = 1,4 to 5,5 pF film dielectric trimmer (cat.no. 2222 809 09001)
- C3 = C6 = 3,9 pF multilayer ceramic chip capacitor\*
- C5 = C8 = C11 = 180 pF multilayer ceramic chip capacitor
- C9 = 1  $\mu\text{F}$  (35 V) tantalum capacitor
- L1 = 50  $\Omega$  stripline (38 mm x 2,4 mm)
- L2 = L5 = 35  $\Omega$  stripline (14 mm x 4 mm)
- L3 = 60 nH; 4 turns closely wound enamelled Cu wire (0,4 mm); int. dia. 3 mm; leads 2 x 5 mm
- L4 = L8 = Ferroxcube wideband h.f. choke, grade 3B (cat.no. 4312 020 36642)
- L6 = 50 nH; 5 turns closely wound enamelled Cu wire (0,6 mm); int. dia. 3 mm; leads 2 x 5 mm
- L7 = 50  $\Omega$  stripline (12,2 mm x 2,4 mm)
- L9 = 50  $\Omega$  stripline (30,5 mm x 2,4 mm)
- R1 = R2 = 10  $\Omega \pm 5\%$ ; 0,25 W metal film resistor

The striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch; thickness of copper-sheet 2 x 35  $\mu\text{m}$ .

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.

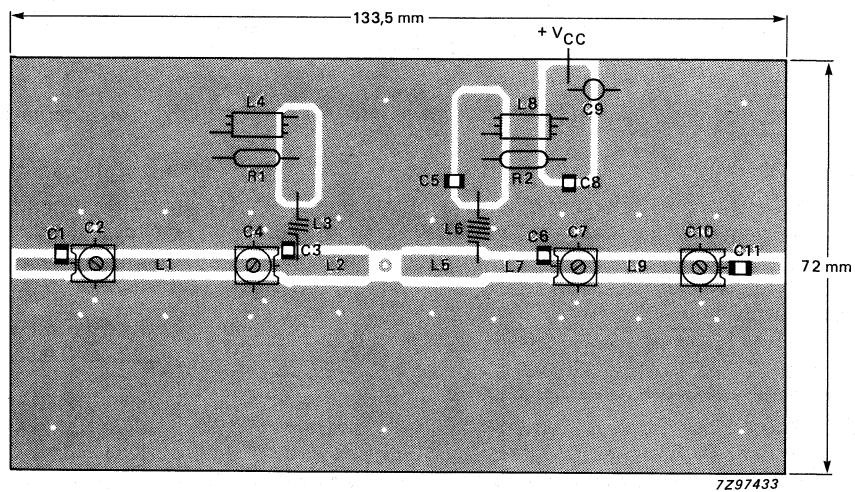
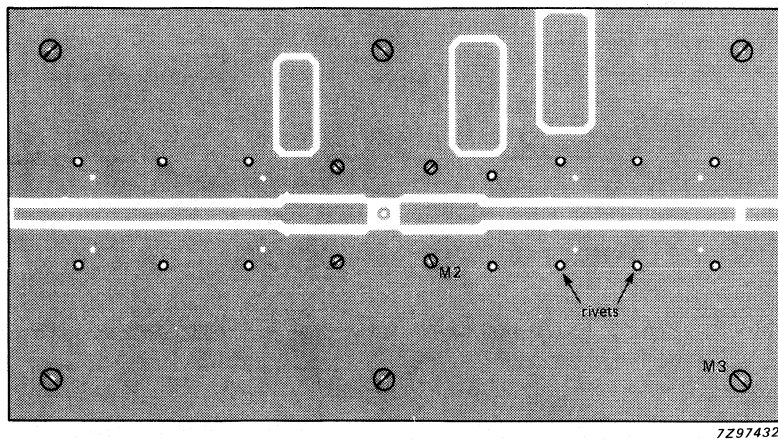


Fig. 4 Printed circuit board and component lay-out for 900 MHz class-B test circuit.

#### Note

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as groundplane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the groundplane.

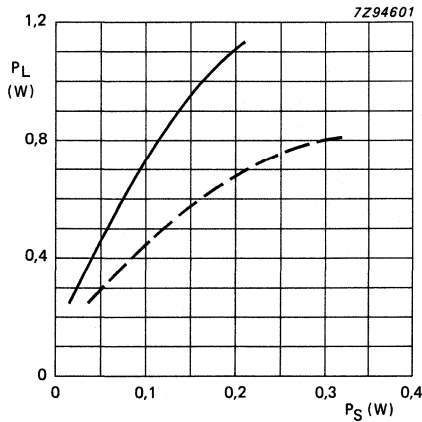


Fig. 5 Load power vs. source power.

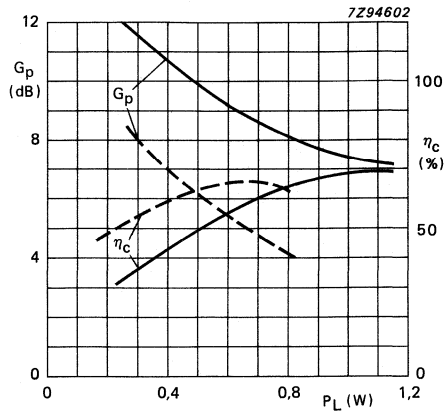


Fig. 6 Power gain and efficiency vs. load power.

Conditions for Figs 5 and 6:

$f = 900 \text{ MHz}$ ;  $T_a = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

$V_{CE} = 7,5 \text{ V}$  (—);  $V_{CE} = 5,0 \text{ V}$  (-----)

(transistor mounted on printed circuit board, shown in Fig. 4, without applying an external heatsink).

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch ( $VSWR = 50$ ; all phases) at rated load power up to a supply voltage of  $9,0 \text{ V}$  at  $T_a = 25 \text{ }^\circ\text{C}$ . Device mounted on a printed circuit board (see Fig. 4).

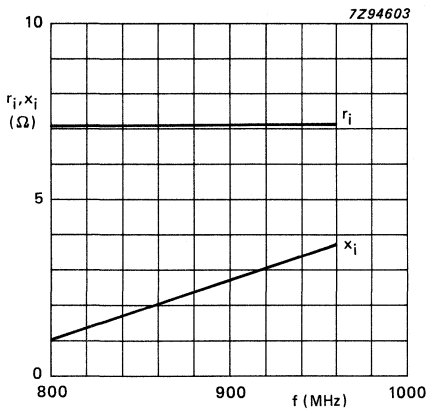


Fig. 7 Input impedance (series components).

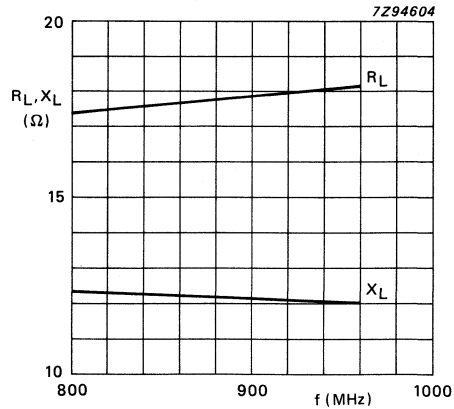


Fig. 8 Load impedance (series components).

Conditions for Figs 7, 8 and 9:

$V_{CE} = 7,5 \text{ V}$ ;  $P_L = 0,75 \text{ W}$ ;  $f = 800 - 960 \text{ MHz}$ ;  $T_a = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.



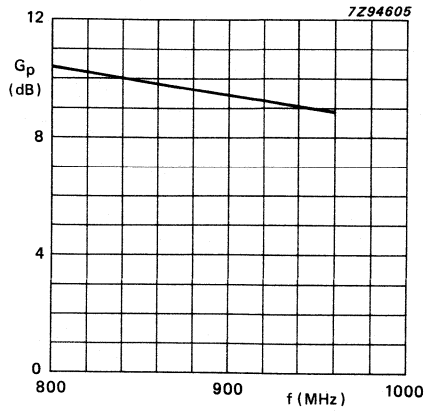


Fig. 9 Power gain vs. frequency.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in handheld radio stations in the 900 MHz communications band.

This device has been designed specifically for class-B operation.

### Features:

- the device can be applied at rated load power without an external heatsink when it is mounted on a printed wiring board.
- gold metallization ensures excellent reliability.

The transistor has a 4-lead studless envelope with a ceramic cap (SOT-172D). All leads are isolated from the mounting base.

### QUICK REFERENCE DATA

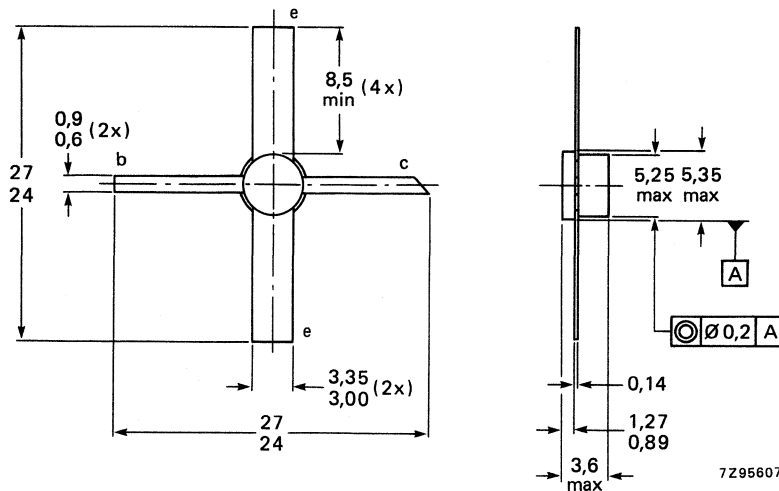
R.F. performance at  $T_a = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
c.w. (class-B)	7,5	900	1,5	> 6,0	> 50

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-172D.



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	10 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
average	$I_C; I_C(AV)$	max.	500 mA
(peak value); $f > 1$ MHz	$I_{CM}$	max.	1500 mA
Total power dissipation			
at $T_{amb} = 50$ °C; $f > 1$ MHz*	$P_{tot}(rf)$	max.	3,0 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

**THERMAL RESISTANCE**Dissipation = 4,5 W;  $T_{mb} = 25$  °C

From junction to ambient* ( $f > 1$ MHz)	$R_{th\ j-a}(rf)$	max.	50 K/W
From junction to mounting base ( $f > 1$ MHz)	$R_{th\ j-mb}(rf)$	max.	20 K/W

\* Device mounted on a printed wiring board (see Fig. 4).

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage

open emitter;  $I_C = 5\text{ mA}$

$$V_{(BR)CBO} > 20\text{ V}$$

Collector-emitter breakdown voltage

open base;  $I_C = 10\text{ mA}$

$$V_{(BR)CEO} > 10\text{ V}$$

Emitter-base breakdown voltage

open collector;  $I_E = 1\text{ mA}$

$$V_{(BR)EBO} > 3\text{ V}$$

Collector cut-off current

$V_{BE} = 0$ ;  $V_{CE} = 10\text{ V}$

$$I_{CES} < 2,5\text{ mA}$$

Second breakdown energy

$L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$$E_{SBR} > 0,55\text{ mJ}$$

D.C. current gain

$I_C = 300\text{ mA}$ ;  $V_{CE} = 5\text{ V}$

$$h_{FE} > 25$$

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = i_e = 0$ ;  $V_{CB} = 7,5\text{ V}$

$$C_c \text{ typ. } 4,5\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 0$ ;  $V_{CE} = 7,5\text{ V}$

$$C_{re} \text{ typ. } 3\text{ pF}$$

Collector-mounting base capacitance

$$C_{c-mb} \text{ typ. } 0,5\text{ pF}$$

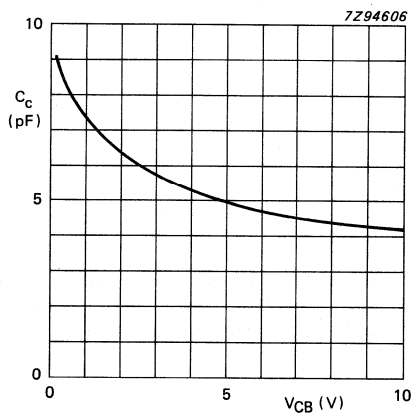
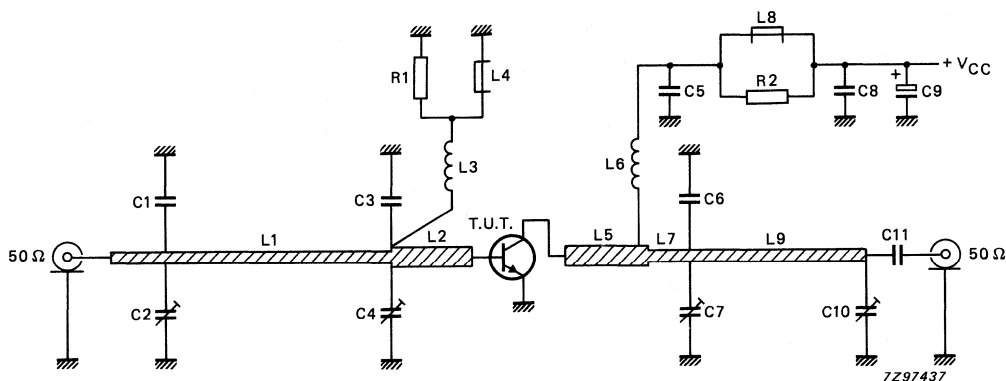


Fig. 2  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class-B):  $f = 900 \text{ MHz}$ ;  $T_a = 25 \text{ }^\circ\text{C}$ 

mode of operation	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	7,5	1,5	> 6,0 typ. 7,0	> 50 typ. 65

Fig. 3 Class-B test circuit at  $f = 900 \text{ MHz}$ .

List of components:

C1 = C6 = 2 pF multilayer ceramic chip capacitor\*

C2 = C4 = C7 = C10 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C3 = 4,7 pF multilayer ceramic chip capacitor\*

C5 = C8 = C11 = 180 pF multilayer ceramic chip capacitor

C9 = 1  $\mu\text{F}$  (35 V) tantalum capacitorL1 = 50  $\Omega$  stripline (40 mm x 2,4 mm)L2 = L5 = 35  $\Omega$  stripline (14 mm x 4,0 mm)

L3 = 100 nH; 8 turns closely wound enamelled Cu wire (0,4 mm); int. dia. 3 mm; leads 2 x 5 mm

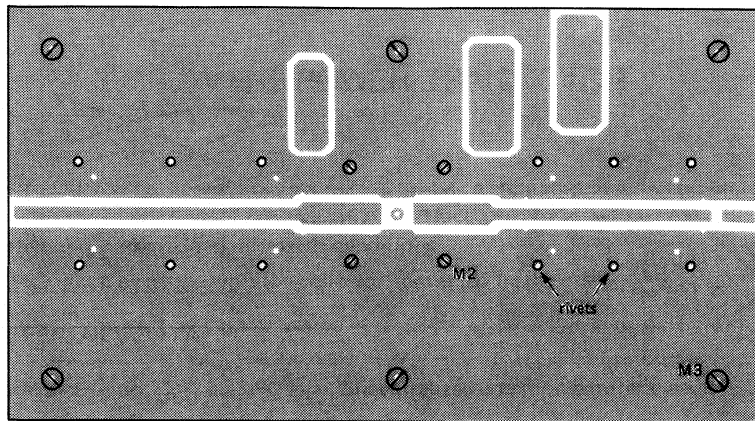
L4 = L8 = Ferroxcube wideband h.f. choke, grade 3B (cat.no. 4312 020 36642)

L6 = 30 nH; 2 turns Cu wire (1,0 mm); int. dia. 5,5 mm; length 4,5 mm; leads 2 x 5 mm.

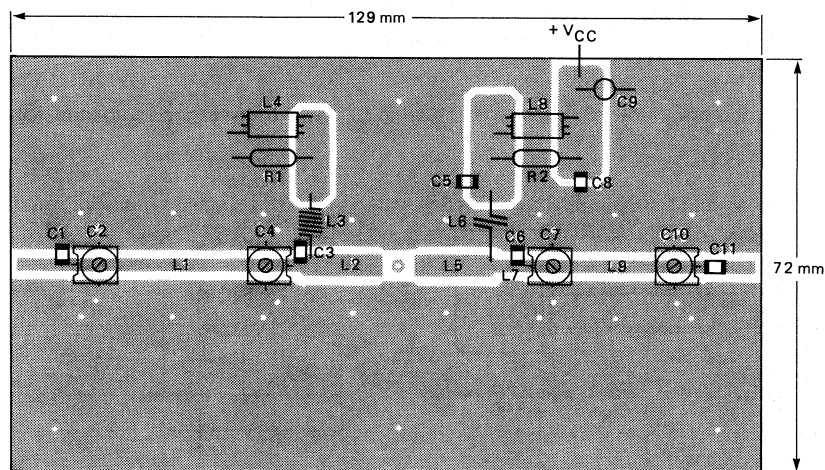
L7 = 50  $\Omega$  stripline (6,0 mm x 2,4 mm)L9 = 50  $\Omega$  stripline (30,3 mm x 2,4 mm)R1 = R2 = 10  $\Omega \pm 5\%$ ; 0,25 W metal film resistor

The striplines on a double Cu-clad printed wiring board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch; thickness of copper-sheet 2 x 35  $\mu\text{m}$ .

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.



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Fig. 4 Printed wiring board and component lay-out for 900 MHz class-B test circuit.

#### Note

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as a groundplane. Earth connections are made by hollow rivets and also by fixing screws and copper straps under the emitters to provide a direct contact between the copper on the component side and the groundplane.

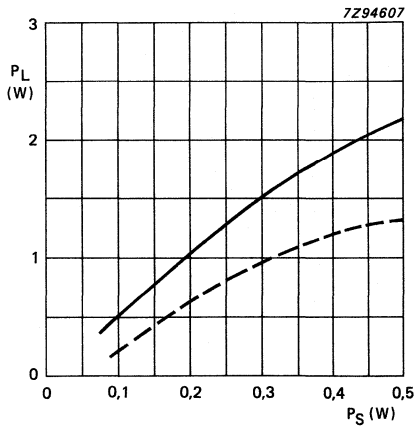


Fig. 5 Load power vs. source power.

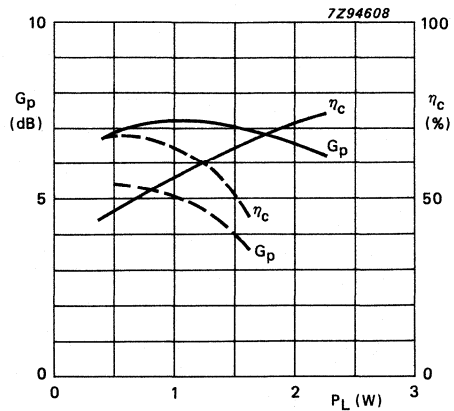


Fig. 6 Power gain and efficiency vs. load power.

Conditions for Figs 5 and 6:

$f = 900$  MHz;  $T_a = 25$  °C; class-B operation; typical values.

$V_{CE} = 7,5$  V (——);  $V_{CE} = 5,0$  V (-----)

(transistor mounted on printed wiring board, shown in Fig. 4, without applying an external heatsink).

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 9,0 V at  $T_a = 25$  °C.

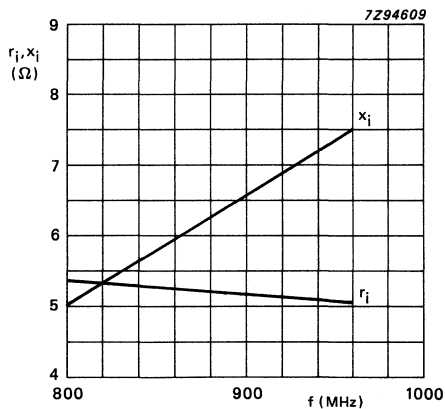


Fig. 7 Input impedance (series components).

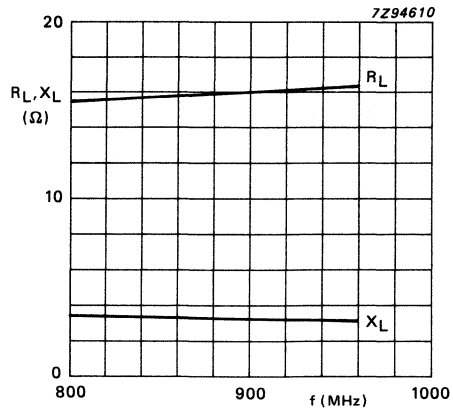


Fig. 8 Load impedance (series components).

Conditions for Figs 7, 8 and 9:

$V_{CE} = 7,5$  V;  $P_L = 1,5$  W;  $f = 800 - 960$  MHz;  $T_a = 25$  °C; class-B operation; typical values.



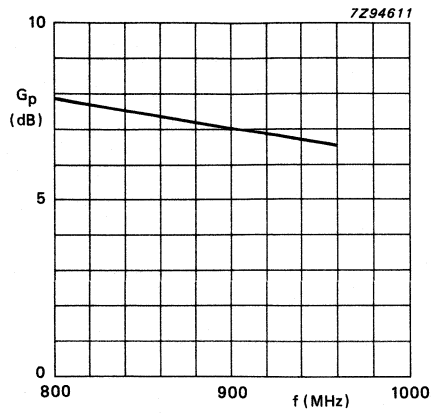


Fig. 9 Power gain vs. frequency.



## UHF POWER TRANSISTOR

NPN silicon planar epitaxial transistor primarily intended for use in handheld radio stations in the 900 MHz communications band.

This device has been designed specifically for class-B operation.

### Features

- internal input matching capacitor for a high power gain
- gold metallization ensures excellent reliability

The transistor has a 4-lead studless envelope with a ceramic cap (SOT122D). All leads are isolated from the mounting base.

### QUICK REFERENCE DATA

RF performance at  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in a common-emitter class-B circuit

mode of operation	VCE V	f MHz	P <sub>L</sub> W	G <sub>p</sub> dB	$\eta_C$ %
CW (class-B)	7.5	900	3.0	> 7.0	> 50

### MECHANICAL DATA

Dimensions in mm

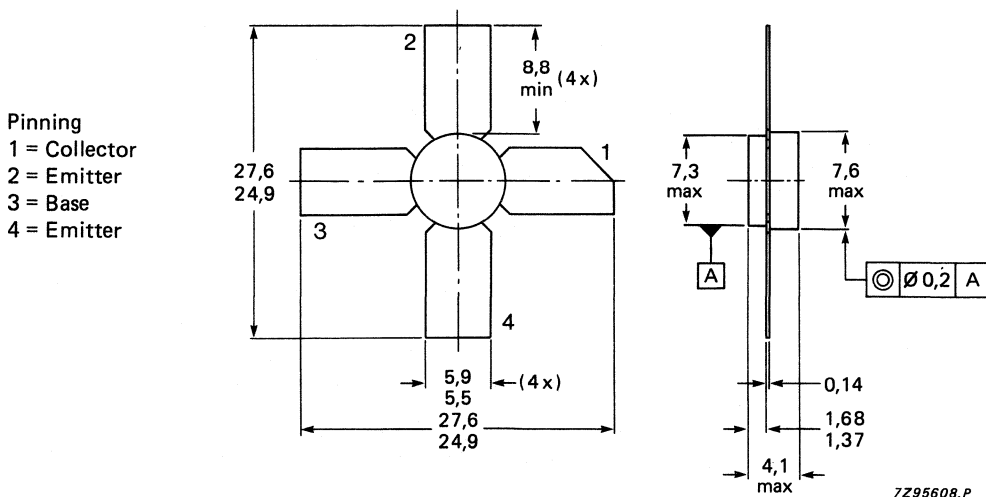


Fig.1 SOT122D.

**PRODUCT SAFETY** This device incorporates beryllium oxide (BeO), the dust of which is toxic. The device is entirely safe provided that the internal BeO disc is not damaged. See also page 6.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	10 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3.0 V
Collector current			
DC or average	$I_C; I_C(AV)$	max.	1.2 A
(peak value); $f > 800$ MHz	$I_{CM}$	max.	3.6 A
Total power dissipation			
at $T_{amb} < 120$ °C; $f > 800$ MHz	$P_{tot}$	max.	10 W
Storage temperature range	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

**THERMAL RESISTANCE**

Dissipation = 10 W;  $T_{mb} = 25$  °C

From junction to mounting base ( $f > 800$ MHz)	$R_{thj-mb}(RF)$	max.	6.0 K/W
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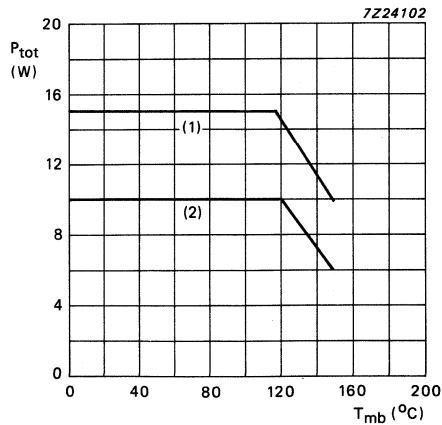


Fig. 2 Total power dissipation as a function of temperature.

- (1) Short-time RF operation during mismatch ( $f > 800$  MHz).
- (2) Continuous RF operation ( $f > 800$  MHz).

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 10\text{ mA}$

$V_{(BR)CBO} > 20\text{ V}$

Collector-emitter breakdown voltage  
open base;  $I_C = 20\text{ mA}$

$V_{(BR)CEO} > 10\text{ V}$

Emitter-base breakdown voltage  
open collector;  $I_E = 2\text{ mA}$

$V_{(BR)EBO} > 3.0\text{ V}$

Collector cut-off current  
 $V_{BE} = 0; V_{CE} = 10\text{ V}$

$I_{CES} < 5.0\text{ mA}$

Second breakdown energy  
 $L = 25\text{ mH}; f = 50\text{ Hz}; R_{BE} = 10\text{ }\Omega$

$E_{SBR} > 1.0\text{ mJ}$

DC current gain  
 $I_C = 600\text{ mA}; V_{CE} = 5\text{ V}$

$h_{FE} > 25$

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0; V_{CB} = 7.5\text{ V}$

$C_c$  typ.  $11\text{ pF}$

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0; V_{CE} = 7.5\text{ V}$

$C_{re}$  typ.  $6.0\text{ pF}$

Collector-mounting base capacitance

$C_{c-mb}$  typ.  $1.2\text{ pF}$

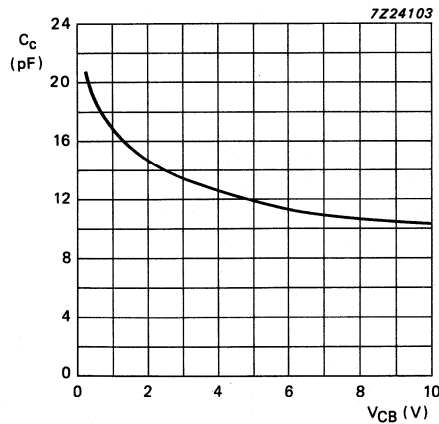
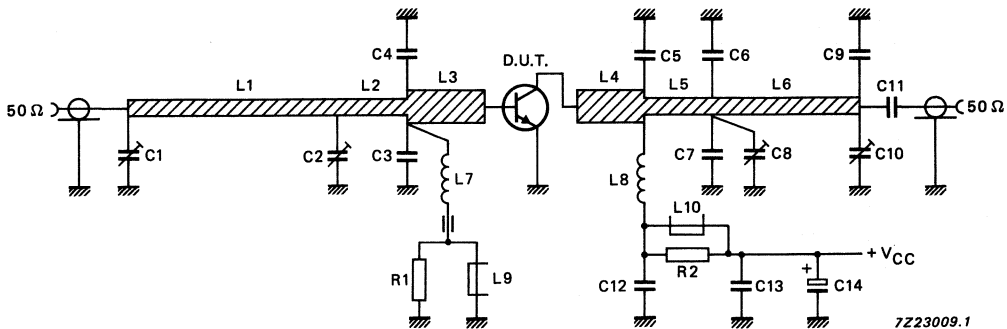


Fig. 3 Collector capacitance as a function of collector-base voltage;  $f = 1\text{ MHz}; I_E = i_e = 0$ ; typical values.

## APPLICATION INFORMATION

RF performance in CW operation (common-emitter circuit; class-B);  $f = 900 \text{ MHz}$ ;  $T_{mb} = 25 \text{ }^\circ\text{C}$ 

mode of operation	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
Class-B; CW	7.5	3.0	> 7.0 typ. 8.5	> 50 typ. 57

Fig.4 Class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components:

- C1 = C2 = C8 = C10 = 1.4 to 5.5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C3 = C6 = C7 = 3.3 pF multilayer ceramic chip capacitor\*
- C4 = C5 = C9 = 5.6 pF multilayer ceramic chip capacitor\*
- C11 = C12 = C13 = 180 pF multilayer ceramic chip capacitor
- C14 = 1  $\mu\text{F}$  (35 V) tantalum capacitor
- L1 = 50  $\Omega$  stripline (25 mm x 2.4 mm)
- L2 = 50  $\Omega$  stripline (11 mm x 2.4 mm)
- L3 = L4 = 25  $\Omega$  stripline (11.5 mm x 6.0 mm)
- L5 = 50  $\Omega$  stripline (7.0 mm x 2.4 mm)
- L6 = 50  $\Omega$  stripline (27.0 mm x 2.4 mm)
- L7 = 4 turns closely wound enamelled Cu wire (0.4 mm), int. dia; 3 mm, with ferrite beat (cat. no. 4330 830 32221) over the coldside lead
- L8 = 1 turn Cu wire (1.0 mm); int. dia. 5.5 mm; length 2 mm; leads 2 x 5 mm
- L9 = L10 = Ferroxcube wideband HF choke, grade 3B (cat. no. 4312 020 36642)
- R1 = R2 = 10  $\Omega \pm 5\%$ ; 0.25 W metal film resistor

The striplines on a double Cu-clad printed circuit board with PTFE fibreglass dielectric ( $E_r = 2.2$ ); thickness 1/32 inch; thickness of copper-sheet 2 x 35  $\mu\text{m}$ .

\* American Technical Ceramics capacitor type 100 A or capacitor of same quality.

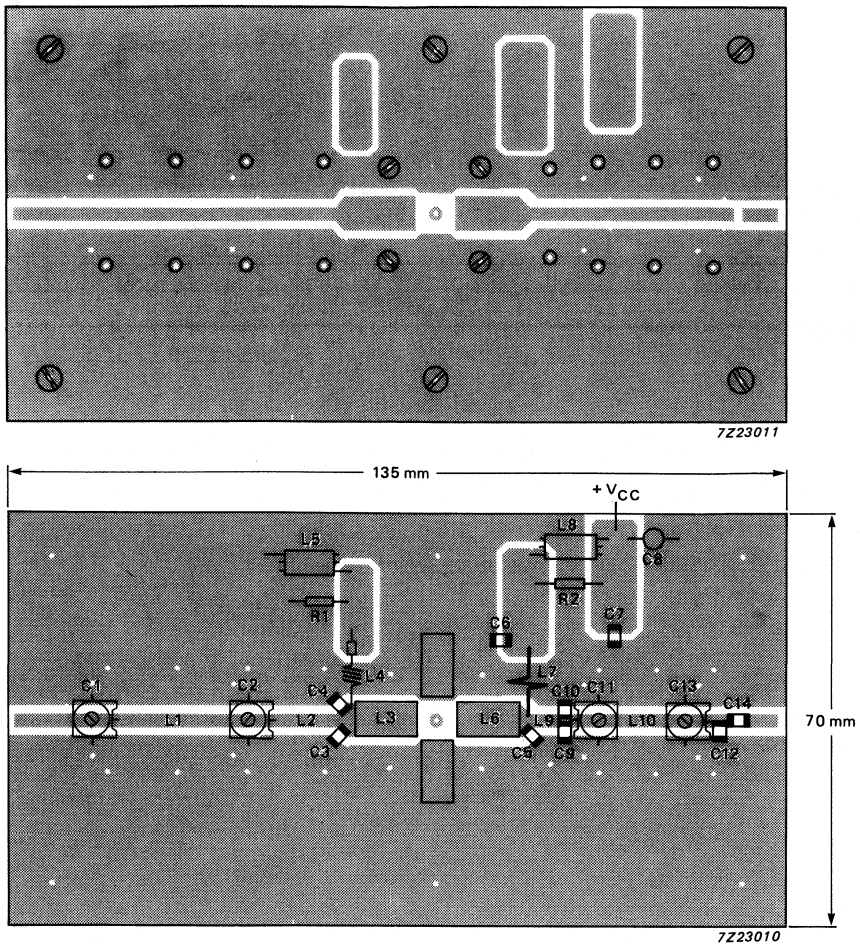


Fig. 5 Printed circuit board and component layout for 900 MHz class-B test circuit.

**Note:**

The circuit and the components are on one side of the PTFE fibreglass board; the other side is un-etched copper serving as groundplane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the groundplane.

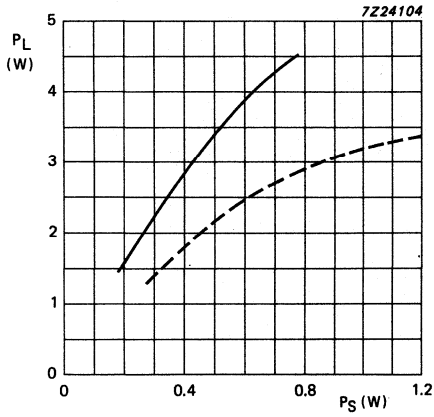


Fig. 6 Load power as a function of source power.

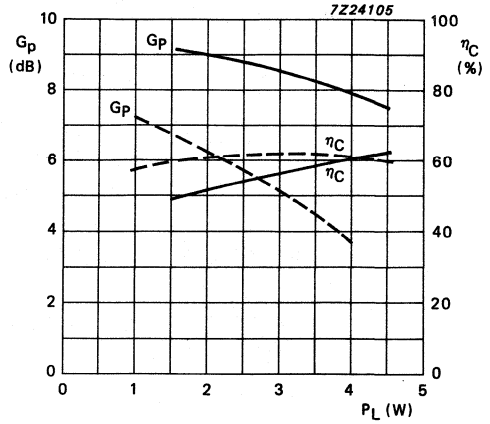


Fig. 7 Power gain and efficiency as a function of load power.

Conditions for Figs 6 and 7:

$f = 900$  MHz;  $T_{mb} = 25$  °C; class-B operation; typical values.

—  $V_{CE} = 7.5$  V

- - -  $V_{CE} = 5.0$  V

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch ( $V_{SWR} = 50$ ; all phases) at rated load power up to a supply voltage of 9.0 V at  $T_{mb} = 25$  °C.



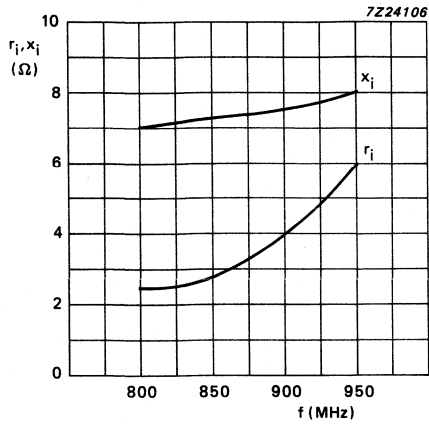


Fig. 8 Input impedance as a function of frequency (series components).

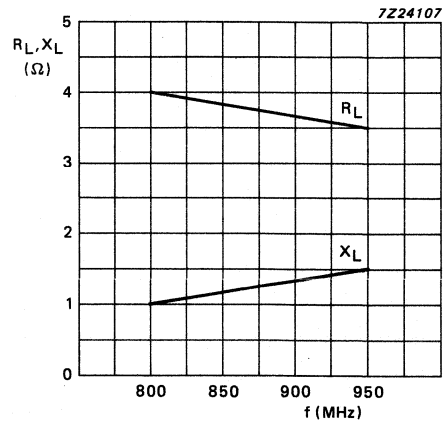


Fig. 9 Load impedance as a function of frequency (series components).

Conditions for Figs 8, 9 and 10:

$V_{CE} = 7,5 \text{ V}$ ;  $P_L = 3 \text{ W}$ ;  $f = 800 - 960 \text{ MHz}$ ;  $T_{mb} = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

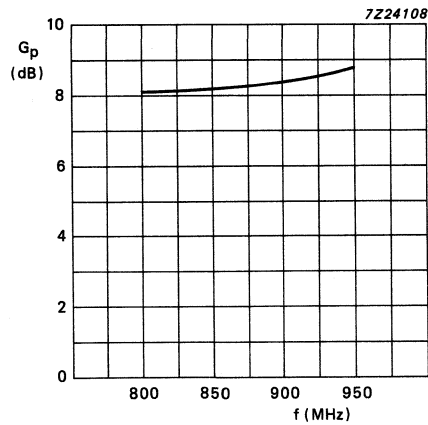


Fig. 10 Power gain as a function of frequency.



## UHF POWER TRANSISTOR

NPN silicon planar epitaxial transistor primarily intended for use in hand-held radio stations in the 900 MHz communications band.

This device has been designed specifically for class-B operation.

### Features

- internal input matching capacitor for a high power gain
- gold metallization ensures excellent reliability

The transistor has a 4-lead studless envelope with a ceramic cap (SOT122D). All leads are isolated from the mounting base.

### QUICK REFERENCE DATA

RF performance at  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in a common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
CW (class-B)	7.5	900	6.0	min. 5.5	min. 50

### MECHANICAL DATA

Dimensions in mm

#### Pinning

- 1 = Collector  
2 = Emitter  
3 = Base  
4 = Emitter

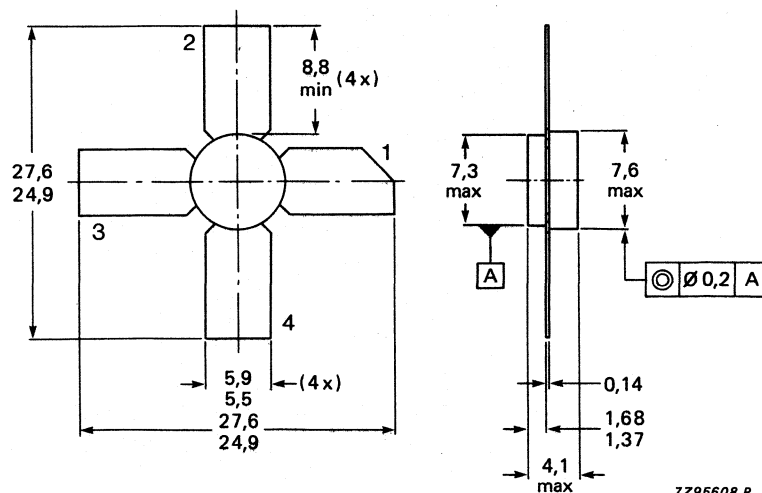


Fig.1 SOT122D.

**PRODUCT SAFETY** This device incorporates beryllium oxide (BeO), the dust of which is toxic. The device is entirely safe provided that the internal BeO disc is not damaged. See also page 6.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134).

Collector-base voltage (open emitter)	$V_{CBO}$	max.	20 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	10 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
DC or average	$I_C; I_{C(AV)}$	max.	1.2 A
(peak value); $f > 200$ MHz	$I_{CM}$	max.	3.6 A
Total power dissipation			
at $T_{amb} < 105$ °C; $f > 200$ MHz	$P_{tot}$	max.	12 W
Storage temperature range	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

**THERMAL RESISTANCE**

Dissipation = 12 W;  $T_{mb} = 25$  °C

From junction to mounting base  
( $f > 200$  MHz)

$R_{th\ j-mb(RF)}$  max. 6.5 K/W

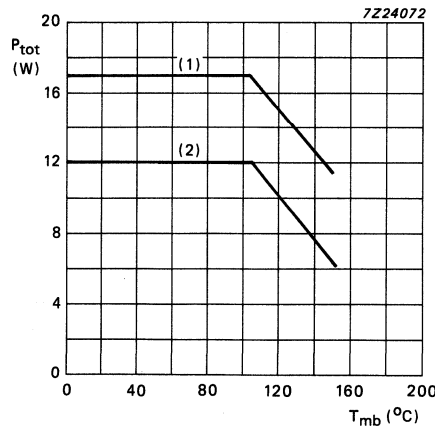


Fig. 2 Total power dissipation as a function of temperature.

- (1) Short-time RF operation during mismatch ( $f > 800$  MHz)
- (2) Continuous RF operation ( $f > 800$  MHz)

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage open emitter; $I_C = 20\text{ mA}$	$V_{(BR)CBO}$	>	20 V
Collector-emitter breakdown voltage open base; $I_C = 40\text{ mA}$	$V_{(BR)CEO}$	>	10 V
Emitter-base breakdown voltage open collector; $I_E = 4\text{ mA}$	$V_{(BR)EBO}$	>	3.0 V
Collector cut-off current $V_{BE} = 0, V_{CE} = 10\text{ V}$	$I_{CES}$	<	1.0 mA
Second breakdown energy $L = 25\text{ mH}; f = 50\text{ Hz}; R_{BE} = 10\text{ }\Omega$	$ESBR$	>	2.0 mJ
DC current gain $I_C = 1.2\text{ A}, V_{CE} = 5\text{ V}$	$h_{FE}$	>	25
Collector capacitance at $f = 1\text{ MHz}$ $I_E = i_e = 0; V_{CB} = 7.5\text{ V}$	$C_c$	typ.	19 pF
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 0, V_{CE} = 7.5\text{ V}$	$C_{re}$	typ.	10 pF
Collector-mounting base capacitance	$C_{c-mb}$	typ.	1.2 pF

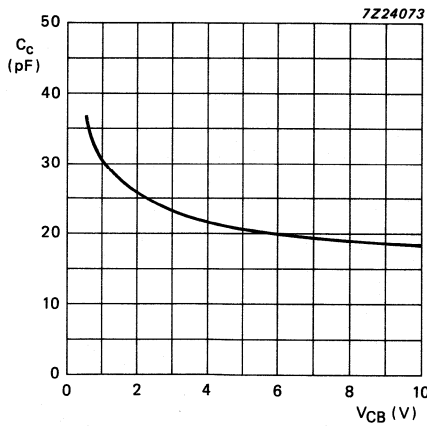
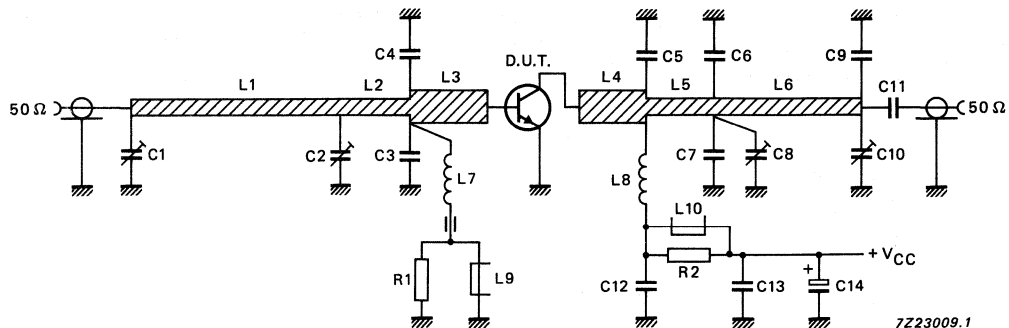


Fig. 3 Collector capacitance as a function of collector-base voltage;  $f = 1\text{ MHz}; I_E = i_e = 0$ ; typical values.

## APPLICATION INFORMATION

RF performance in CW operation (common-emitter circuit; class-B);  $f = 900 \text{ MHz}$ ;  $T_{mb} = 25 \text{ }^\circ\text{C}$ 

mode of operation	f MHz	V <sub>CE</sub> V	P <sub>L</sub> W	G <sub>p</sub> dB	$\eta_C$ %
class-B; CW	900	7.5	6.0	min. 5.5 typ. 7.0	min. 50 typ. 60

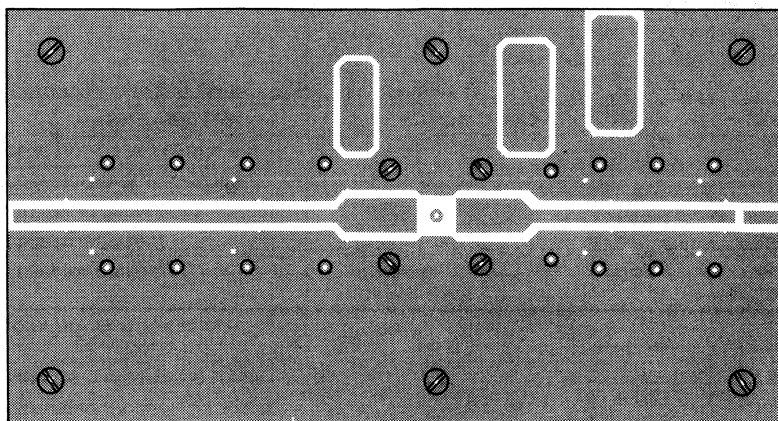
Fig. 4 Class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components:

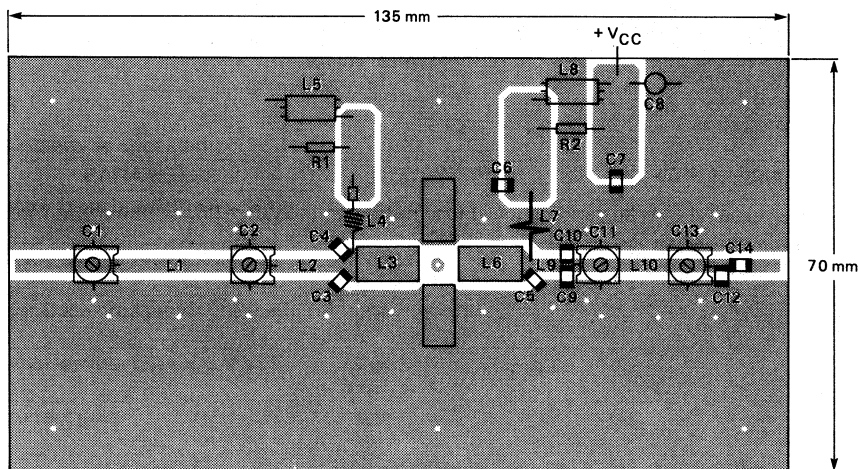
- C1 = C2 = C8 = C10 = 1.4 to 5.5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C3 = C6 = C7 = 3.3 pF multilayer ceramic chip capacitor\*
- C4 = C5 = C9 = 5.6 pF multilayer ceramic chip capacitor\*
- C11 = C12 = C13 = 180 pF multilayer ceramic chip capacitor
- C14 = 1  $\mu\text{F}$  (35 V) tantalum capacitor
- L1 = 50  $\Omega$  stripline (25 mm x 2.4 mm)
- L2 = 50  $\Omega$  stripline (11 mm x 2.4 mm)
- L3 = L4 = 25  $\Omega$  stripline (11.5 mm x 6.0 mm)
- L5 = 50  $\Omega$  stripline (7.0 mm x 2.4 mm)
- L6 = 50  $\Omega$  stripline (27.0 mm x 2.4 mm)
- L7 = 4 turns closely wound enamelled Cu wire (0.4 mm), int. diameter 3 mm, with ferrite bead (cat. no. 4330 030 32221) over the coldside lead
- L8 = 1 turn Cu wire (1.0 mm); int. diameter 5.5 mm; length 2 mm, leads 2 x 5 mm
- L9 = L10 = Ferroxdure wideband HF choke, grade 3B (cat. no. 4312 020 36642)
- R1 = R2 = 10  $\Omega \pm 5\%$ ; 0.25 W metal film resistor

The striplines on a double Cu-clad printed circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch; thickness of copper-sheet 2 x 35  $\mu\text{m}$ .

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.



7Z23011



7Z23010

Fig. 5 Printed circuit board and component layout for 900 MHz class-B test circuit.

**Note:**

The circuit and the components are on one side of the PTFE fibreglass board; the other side is un-etched copper serving as groundplane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the groundplane.

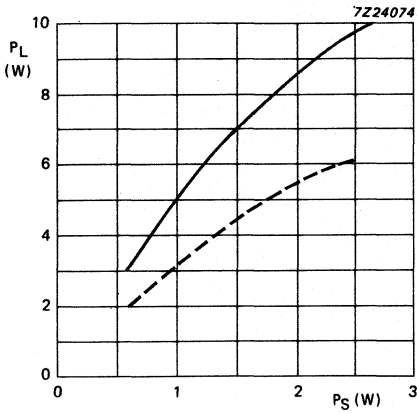


Fig. 6 Load power as a function of source power.

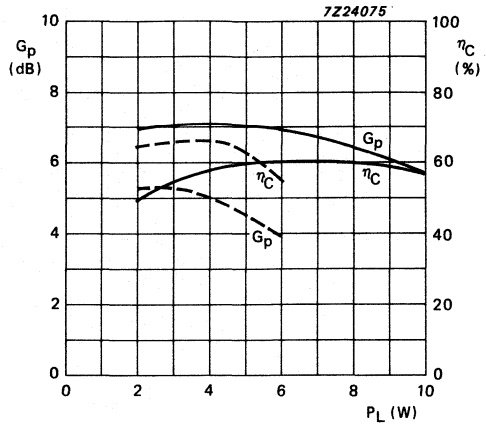


Fig. 7 Power gain and efficiency as a function of load power.

**Conditions for Figs 6 and 7:**

$f = 900$  MHz;  $T_{mb} = 25$  °C; class-B operation; typical values.

- $V_{CE} = 7.5$  V;
- - -  $V_{CE} = 5.0$  V

**RUGGEDNESS:**

The device is capable of withstanding a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 9.0 V at  $T_{mb} = 25$  °C.



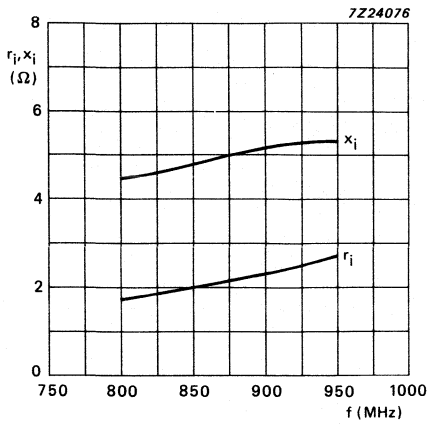


Fig. 8 Input impedance as a function of frequency (series components).

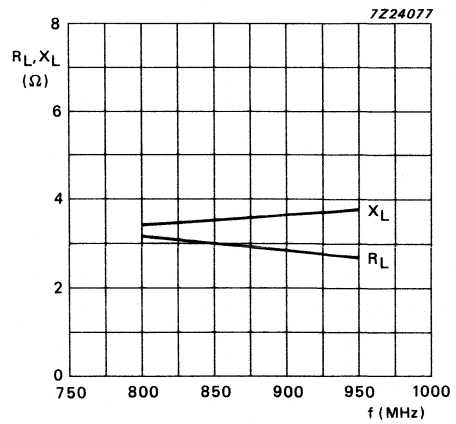


Fig. 9 Load impedance as a function of frequency (series components).

Conditions for Figs 8, 9 and 10:

$V_{CE} = 7.5$  V;  $P_L = 6$  W;  $f = 800 - 960$  MHz;  $T_{mb} = 25$  °C; class-B operation; typical values.

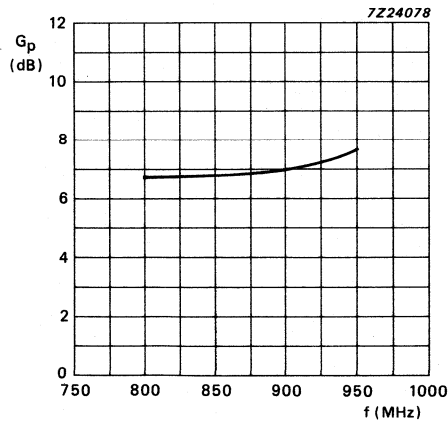


Fig. 10 Power gain as a function of frequency.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in mobile transmitters in the 470 MHz band.

### Features

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile.
- gold metallization ensures excellent reliability.
- the device can be applied at a  $P_L$  of max. 1,5 W when it is mounted on a printed wiring board (see Fig. 6) without an external heatsink.

The transistor has a 4-lead envelope with a ceramic cap (SOT-122D). All leads are isolated from the mounting base.

### QUICK REFERENCE DATA

R.F. performance in a common-emitter class-B circuit.

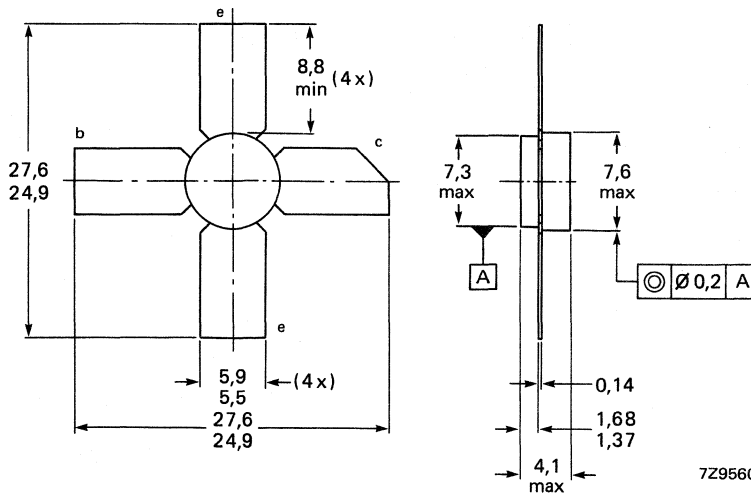
mode of operation	$T_{oC}$	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	$T_{mb} = 25$	12,5	470	2,5	> 10	> 55
	$T_a = 25^*$	12,5	470	1,5	> 12	> 55

\* Device mounted on a printed wiring board (see Fig. 6).

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122D.



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	V <sub>CB0</sub>	max.	36 V
Collector-emitter voltage (open base)	V <sub>CEO</sub>	max.	16 V
Emitter-base voltage (open collector)	V <sub>EBO</sub>	max.	3 V
Collector current			
d.c. or average	I <sub>C</sub> : I <sub>C(AV)</sub>	max.	0,4 A
(peak value), f > 1 MHz	I <sub>CM</sub>	max.	1,2 A
Total power dissipation			
at T <sub>mb</sub> ≤ 90 °C; f > 1 MHz	P <sub>tot(rf)</sub>	max.	6 W
Storage temperature	T <sub>stg</sub>		-65 to +150 °C
Operating junction temperature	T <sub>j</sub>	max.	200 °C

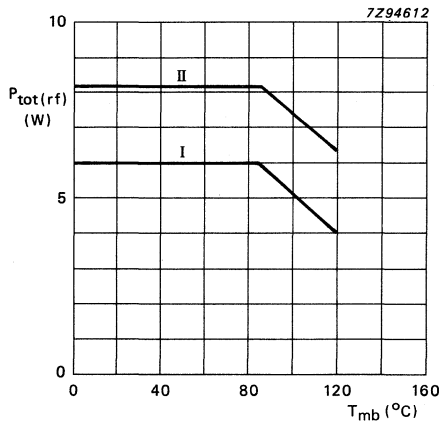


Fig. 2 Power/temperature derating curves.

- I Continuous r.f. operation (f > 1 MHz)
- II Short-time r.f. operation during mismatch (f > 1 MHz)

**THERMAL RESISTANCE**

Dissipation = 4,5 W

From junction to ambient\*  
 at T<sub>a</sub> = 25 °C; f > 1 MHz  
 (r.f. operation)

R<sub>th j-a</sub> (rf) max. 50 K/W

From junction to mounting base  
 at T<sub>mb</sub> = 25 °C; f > 1 MHz  
 (r.f. operation)

R<sub>th j-mb</sub> (rf) max. 15 K/W

\* Device mounted on a printed wiring board (see Fig. 6).

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 5\text{ mA}$

Collector-emitter breakdown voltage  
open base;  $I_C = 10\text{ mA}$

Emitter-base breakdown voltage  
open collector;  $I_E = 0,5\text{ mA}$

Collector cut-off current  
 $V_{BE} = 0; V_{CE} = 16\text{ V}$

Second breakdown energy  
 $L = 25\text{ mH}; f = 50\text{ Hz}; R_{BE} = 10\text{ }\Omega$

D.C. current gain  
 $I_C = 0,3\text{ A}; V_{CE} = 10\text{ V}$

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0; V_{CB} = 12,5\text{ V}$

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0; V_{CE} = 12,5\text{ V}$

Collector-mounting base capacitance

$V_{(BR)CBO}$  min. 36 V

$V_{(BR)CEO}$  min. 16 V

$V_{(BR)EBO}$  min. 3 V

$I_{CES}$  max. 2,5 mA

ESBR min. 0,55 mJ

$h_{FE}$  min. 25

$C_c$  typ. 4 pF

$C_{re}$  typ. 2,5 pF

$C_{c-mb}$  typ. 1,2 pF

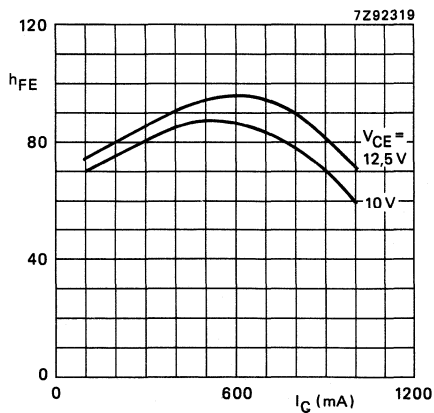


Fig. 3  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

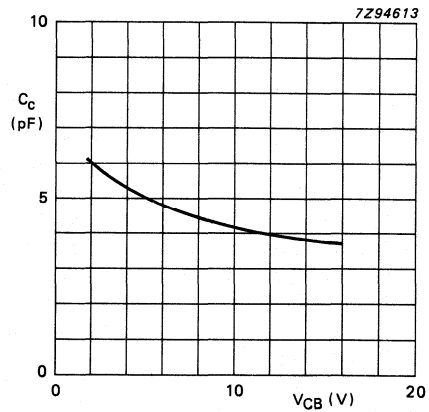


Fig. 4  $I_E = i_e = 0; f = 1\text{ MHz}$ ; typical values.

**APPLICATION INFORMATION**

R.F. performance in common-emitter circuit; class-B;  $f = 470 \text{ MHz}$ ; circuit tuned at  $P_L = 2,5 \text{ W}$ .

mode of operation	$T_{oC}$	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	$T_{mb} = 25$	12,5	470	2,5	$> 10$	$> 55$
	$T_{mb} = 25$				typ. 12	typ. 60
	$T_a = 25^{**}$	12,5	470	1,5	$> 12$	$> 55$

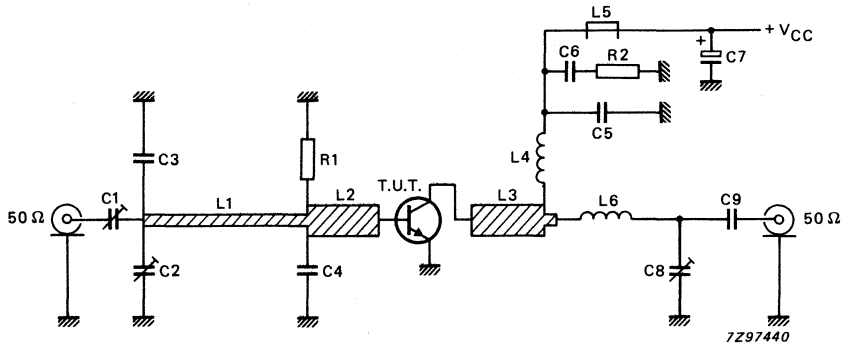


Fig. 5 Class-B test circuit at  $f = 470 \text{ MHz}$ .

List of components:

- C1 = C2 = 2-9 pF film dielectric trimmer (cat. no. 2222 809 09002)
  - C3 = 1,6 pF multilayer ceramic chip capacitor\*
  - C4 = 10 pF multilayer ceramic chip capacitor\*
  - C5 = 100 pF multilayer ceramic chip capacitor
  - C6 = 3 x 100 nF multilayer ceramic chip capacitor (cat. no. 2222 809 47104)
  - C7 = 2,2  $\mu\text{F}$  (35 V) tantalum electrolytic capacitor
  - C8 = 1,4 - 55 pF film dielectric trimmer (cat. no. 2222 809 09001)
  - C9 = 5,6 pF multilayer ceramic chip capacitor\*
  - L1 = 56  $\Omega$  stripline (25,5 mm x 2 mm)
  - L2 = L3 = 25  $\Omega$  stripline (11 mm x 6 mm)
  - L4 = 132 nH; 6 turns closely wound enamelled Cu-wire (1 mm), int. dia. 6 mm, leads 2 x 5 mm
  - L5 = Ferroxcube h.f. choke, grade 3B (cat. no. 4312 020 36642)
  - L6 = 16 nH; 1 turn enamelled Cu-wire (1 mm), int. dia. 6 mm, leads 2 x 5 mm
  - R1 = 10  $\Omega$ ;  $\pm 5\%$  0,4 W metal film resistor
  - R2 = 10  $\Omega$ ;  $\pm 5\%$  0,4 W metal film resistor
- L1, L4 and L5 are striplines on a double Cu-clad printed wiring board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,2$ ) and a thickness of 1/32 inch; thickness of copper-sheet 2 x 35  $\mu\text{m}$ .

\* American Technical Ceramics capacitor type B or capacitor of the same quality.

\*\* Device mounted on a printed wiring board (see Fig. 6).

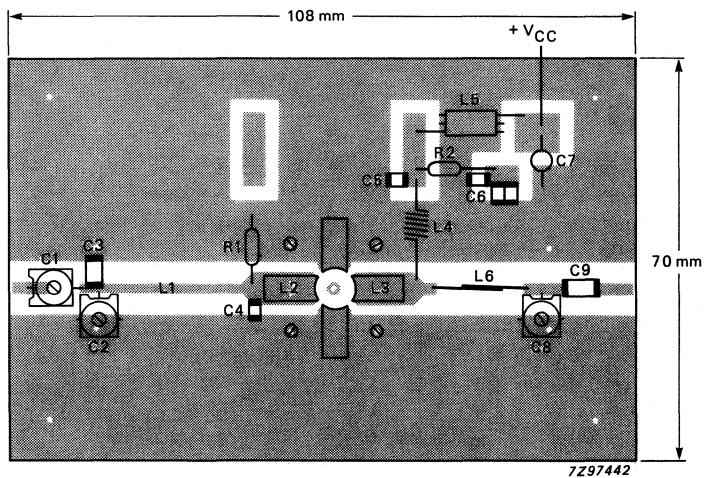
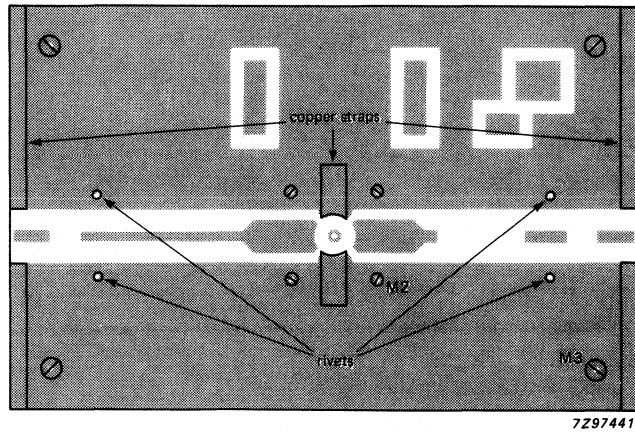


Fig. 6 Printed wiring board and component lay-out for 470 MHz class-B test circuit.

#### Note

The circuit and the components are situated on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as a groundplane. Earth connections are made by using hollow rivets, fixing-screws and copper straps at the input and output and under the two emitters to provide a direct contact between the copper on the component side and the groundplane.

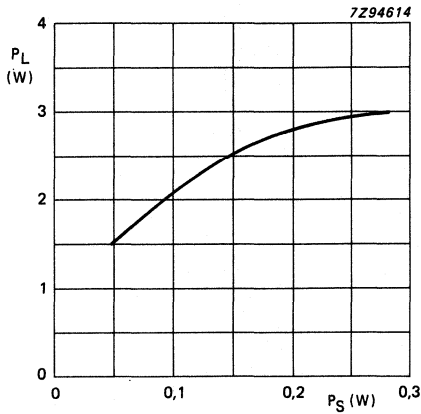


Fig. 7 Load power versus source power.

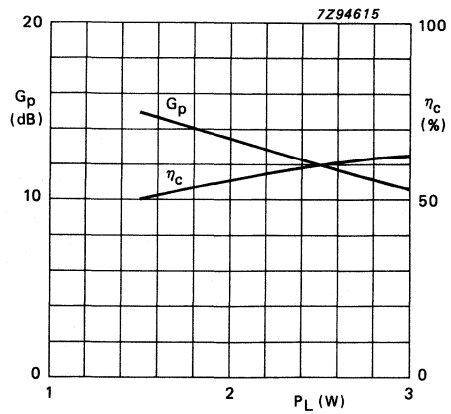


Fig. 8 Power gain and efficiency versus load power.

Conditions for Figs 7 and 8:

$V_{CE} = 12,5 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_{mb} = 25 \text{ }^\circ\text{C}$ ; class-B operation; test circuit tuned at  $P_L = 2,5 \text{ W}$ ; typical values.

**RUGGEDNESS**

The BLU11/SL is capable of withstanding a full load mismatch (VSWR = 50 through all phases) at  $P_L = 2,5 \text{ W}$  up to a supply voltage of  $15,5 \text{ V}$  and  $T_{mb} = 25 \text{ }^\circ\text{C}$ .

Input and output impedances (series components) versus frequency:

$V_{CE} = 12,5 \text{ V}$ ;  $P_L = 2,5 \text{ W}$ ;  $f = 400 \text{ to } 512 \text{ MHz}$ ;  $T_{mb} = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

frequency (MHz)	$Z_i (\Omega)$	$Z_o (\Omega)$
400	$4,0 - j 4,1$	$13,1 + j 7,2$
430	$4,0 - j 3,3$	$13,3 + j 7,0$
460	$4,0 - j 2,6$	$13,6 + j 6,9$
490	$4,1 - j 1,9$	$13,8 + j 6,8$
512	$4,1 - j 1,5$	$13,8 + j 6,7$



# UHF power transistor

# BLU15/12

## FEATURES

- Internal input matching, to achieve wide bandwidth
- Ballasting resistors for optimum temperature profile
- Gold metallization ensures excellent reliability.

## DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a SOT122 envelope and intended for common emitter, class-B operation in mobile radio transmitters in the 450 MHz communications band.

The transistor has a 4-lead stud envelope with a ceramic cap. All leads are isolated from the flange.

## PINNING - SOT122

PIN	DESCRIPTION
1	collector
2	emitter
3	base
4	emitter

## QUICK REFERENCE DATA

RF performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common emitter test circuit.

MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$G_p$ (dB)	$\eta_c$ (%)
c.w. class-B	470	12.5	15	> 7.8	> 55

## WARNING

### Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

## PIN CONFIGURATION

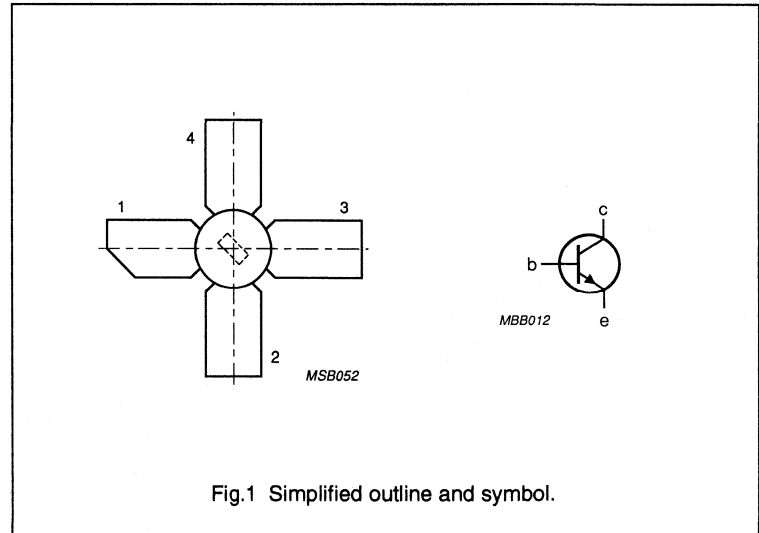


Fig.1 Simplified outline and symbol.

# UHF power transistor

BLU15/12

## LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	-	36	V
$V_{CEO}$	collector-emitter voltage	open base	-	16	V
$V_{EBO}$	emitter-base voltage	open collector	-	3.5	V
$I_C, I_{C(AV)}$	collector current	DC or average value	-	3	A
$I_{CM}$	collector current	peak value $f > 1$ MHz	-	9	A
$P_{tot}$	total power dissipation	$T_{mb} = 25$ °C	-	35	W
$T_{stg}$	storage temperature range		-65	150	°C
$T_j$	operating junction temperature		-	200	°C

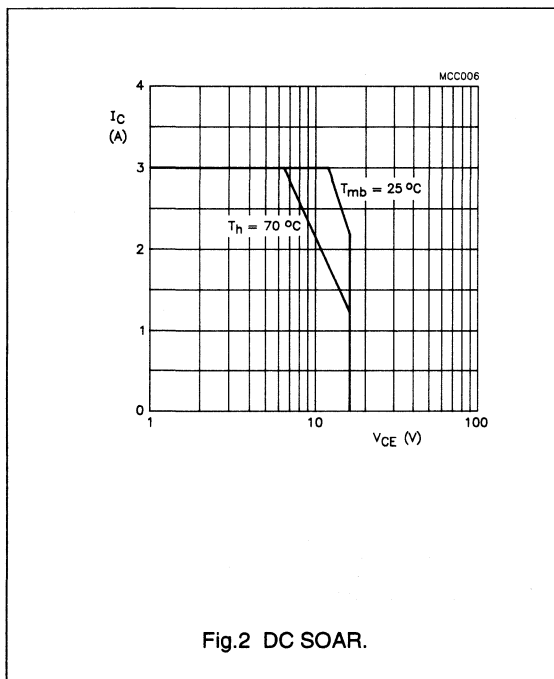
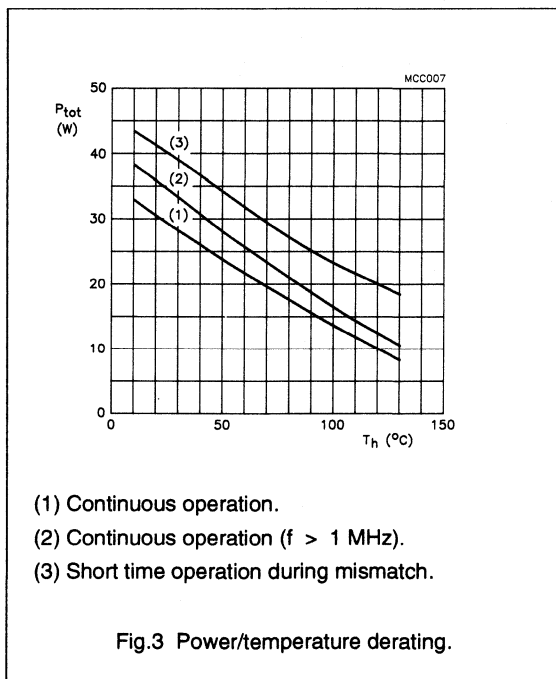


Fig.2 DC SOAR.



- (1) Continuous operation.
- (2) Continuous operation ( $f > 1$  MHz).
- (3) Short time operation during mismatch.

Fig.3 Power/temperature derating.

## THERMAL RESISTANCE

SYMBOL	PARAMETER	MAX.	UNIT
$R_{th\ j-mb}$	from junction to mounting base	5	K/W
$R_{th\ mb-h}$	from mounting base to heatsink	0.6	K/W

## UHF power transistor

BLU15/12

## CHARACTERISTICS

 $T_j = 25^\circ\text{C}$ .

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter; $I_C = 25\text{ mA}$	36	—	—	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base; $I_C = 50\text{ mA}$	16	—	—	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector; $I_E = 5\text{ mA}$	3.5	—	—	V
$I_{CES}$	collector-emitter leakage current	$V_{BE} = 0$ ; $V_{CE} = 16\text{ V}$	—	—	10	mA
$h_{FE}$	DC current gain	$V_{CE} = 10\text{ V}$ ; $I_C = 2\text{ A}$	15	65	—	
$C_c$	collector capacitance	$V_{CB} = 12.5\text{ V}$ ; $I_E = I_e = 0$ ; $f = 1\text{ MHz}$	—	33	—	pF
$C_{re}$	feedback capacitance	$V_{CE} = 12.5\text{ V}$ ; $I_C = 0$ ; $f = 1\text{ MHz}$	—	24	—	pF
$C_{cs}$	collector-stud capacitance		—	1.2	—	pF

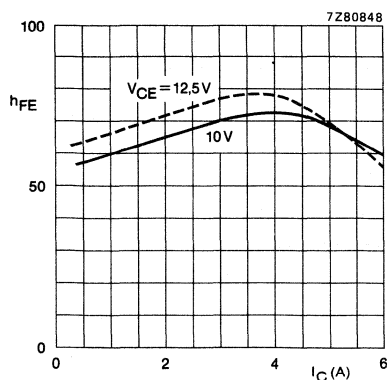


Fig.4 DC current gain as a function of collector current; typical values.

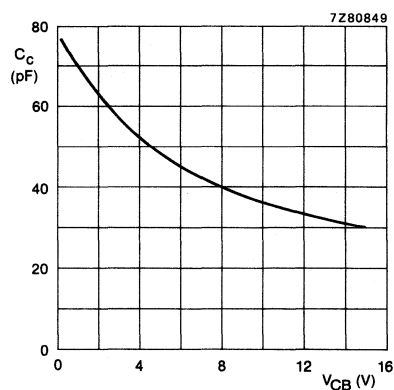


Fig.5 Collector capacitance as a function of collector-base voltage; typical values.

## UHF power transistor

BLU15/12

## APPLICATION INFORMATION

RF performance in a common emitter test circuit;  $T_h = 25\text{ }^\circ\text{C}$ ;  $R_{th\ mb-h} = 0.6\text{ K/W}$ .

MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$G_p$ (dB)	$\eta_c$ (%)
c.w. class-B	470	12.5	15	> 7.8 typ. 8.8	> 55 typ. 63

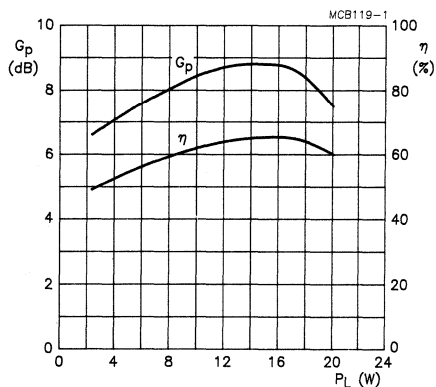


Fig.6 Power gain and efficiency as functions of load power; typical values.

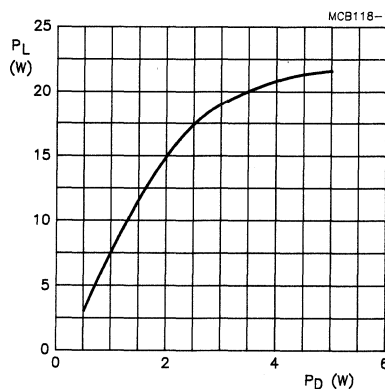


Fig.7 Load power as a function of drive power; typical values.

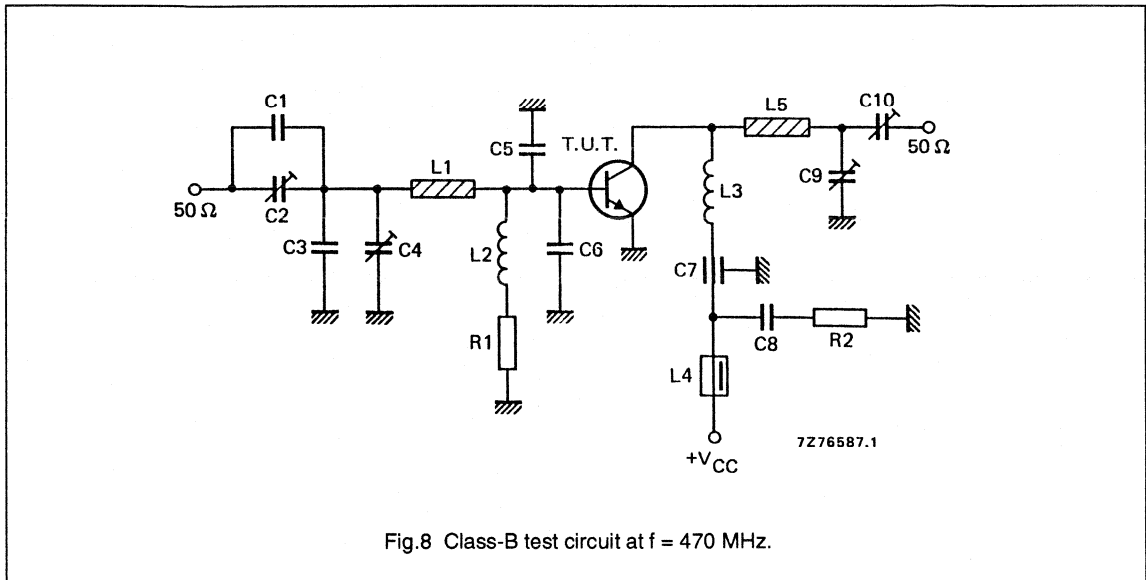
## Ruggedness in class-B operation

The BLU15/12 is capable of withstanding a load mismatch corresponding to  $VSWR = 50:1$  through all phases under the following conditions:

$V_{CE} = 15.5\text{ V}$ ,  $f = 470\text{ MHz}$ ,  
 $T_h = 25\text{ }^\circ\text{C}$  and  $R_{th\ mb-h} = 0.6\text{ K/W}$ , at rated output power.

## UHF power transistor

BLU15/12

Fig.8 Class-B test circuit at  $f = 470$  MHz.

## List of components (see test circuit)

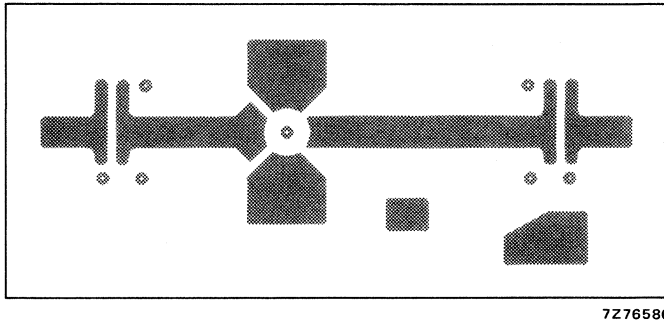
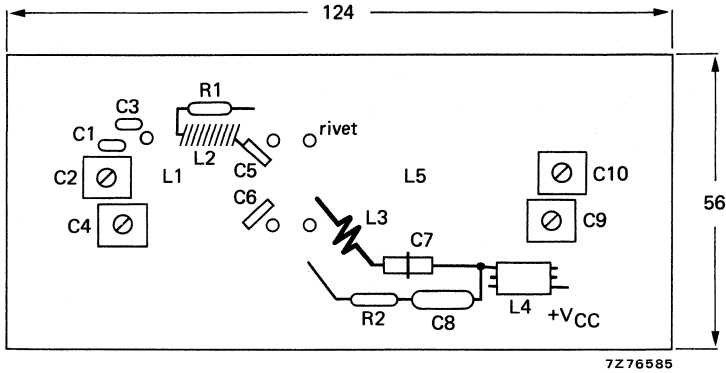
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	ceramic capacitor	$2.2 \pm 0.25$ pF		
C2, C9, C10	film dielectric trimmer	2 to 18 pF		2222 809 09003
C3	ceramic capacitor	$3.9 \pm 0.25$ pF		
C4	film dielectric trimmer	1.4 to 5.5 pF		2222 809 09001
C5, C6	multilayer ceramic chip capacitor	15 pF		2222 851 13159
C7	ceramic feed-through capacitor	100 pF		
C8	polyester capacitor	100 nF		
L1	stripline (note 1)		27.9 x 6 mm	
L2	13 turns closely wound enamelled 0.5 mm copper wire		int. dia. 4 mm leads 2 x 5 mm	
L3	1½ turns enamelled 1 mm copper wire	17 nH	int. dia. 6 mm leads 2 x 5 mm spacing 1 mm	
L4	grade 3B Ferroxcube wideband RF choke			4312 020 36640
L5	stripline (note 1)		45.8 x 6 mm	
R1	carbon resistor	1 Ω, 5%		
R2	carbon resistor	10 Ω, 5%		

## Note

- The striplines L1 and L5 are mounted on a double copper-clad printed circuit board, with PTFE fibre-glass dielectric ( $\epsilon_r = 2.74$ ); thickness  $\frac{1}{16}$  inch.

# UHF power transistor

BLU15/12

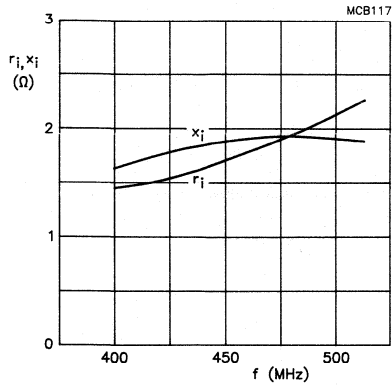


The circuit and components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as an earth. Earth connections from the component side to the ground plane are made by means of hollow rivets.

Fig.9 Component layout and printed circuit board for 470 MHz class-B test circuit.

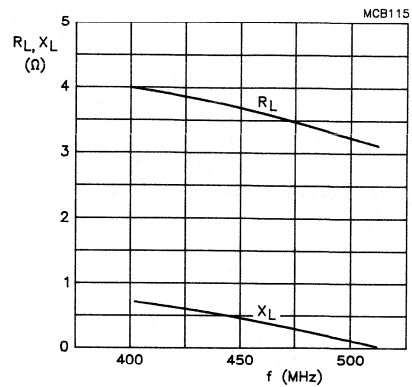
## UHF power transistor

BLU15/12



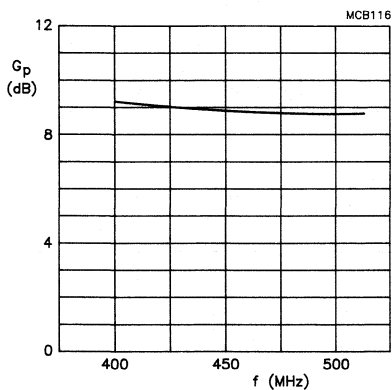
Class-B operation;  $V_{CE} = 12.5$  V;  $P_L = 15$  W.

Fig.10 Input impedance (series components) as a function of frequency, typical values.



Class-B operation;  $V_{DS} = 12.5$  V;  $P_L = 15$  W.

Fig.11 Load impedance (series components) as a function of frequency, typical values.



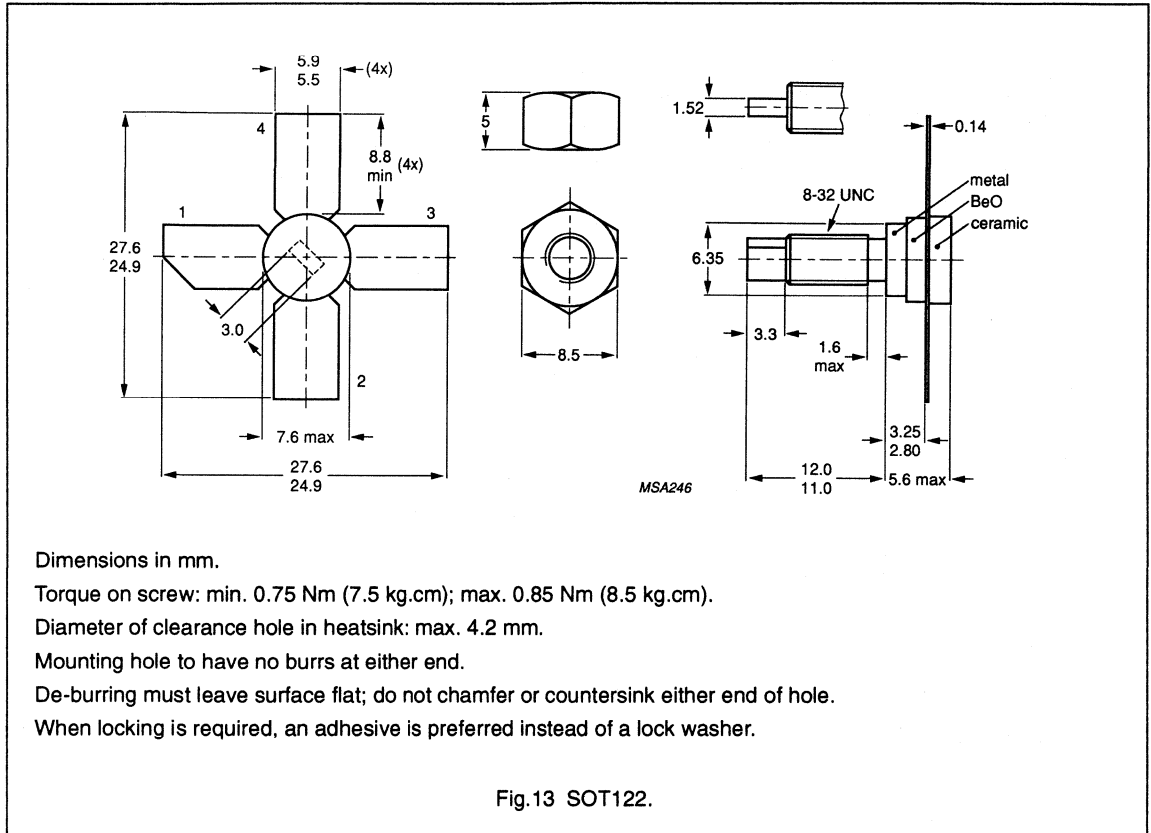
Class-B operation;  $V_{DS} = 12.5$  V;  $P_L = 15$  W.

Fig.12 Power gain as a function of frequency, typical values.

## UHF power transistor

BLU15/12

## PACKAGE OUTLINE





## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in mobile radio transmitters in the 470 MHz communications band.

Features:

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability.
- internal matching to achieve an optimum wideband capability and high power gain.

The transistor has a 6-lead flange envelope with a ceramic cap (SOT-119). All leads are isolated from the flange.

### QUICK REFERENCE DATA

Envelope	SOT-119	
Mode of operation	class-B; c.w.	
Collector-emitter voltage (d.c.)	$V_{CE}$	12,5 V
Frequency	f	470 MHz
Load power	$P_L$	20 W
Power gain	$G_p$	> 6,5 dB
Collector efficiency	$\eta_c$	> 55 %
Heatsink temperature	$T_h$	25 °C

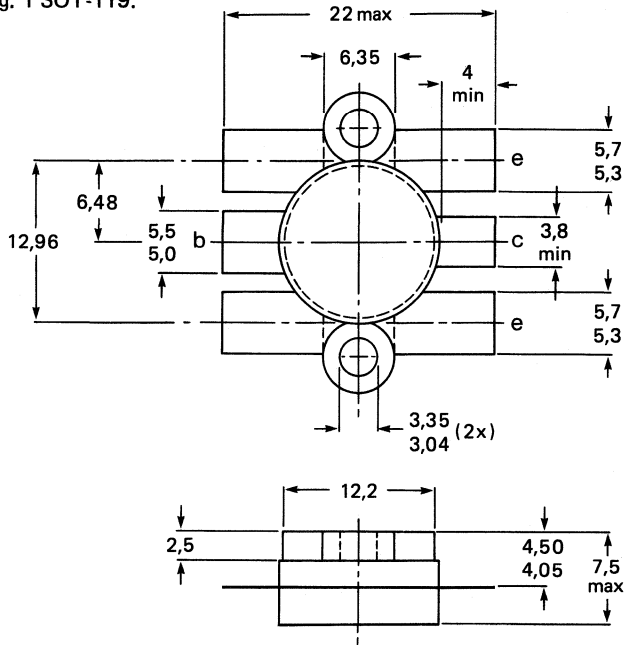
### MECHANICAL DATA

SOT-119 (see Fig. 1).

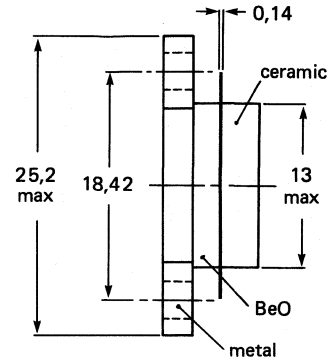
**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**MECHANICAL DATA**

Fig. 1 SOT-119.



**Dimensions in mm**



7277385.6

Torque on screw: min. 0,6 Nm (6 kg.cm)  
max. 0,75 Nm (7,5 kg.cm)

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134).

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16,5 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average (peak value); $f > 1$ MHz	$I_C$ $I_{CM}$	max.	4 A 12 A
Total power dissipation at $T_{mb} = 25$ °C $f > 1$ MHz; $T_{mb} = 25$ °C	$P_{tot}$ (d.c.) $P_{tot}$ (r.f.)	max.	38 W 44 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

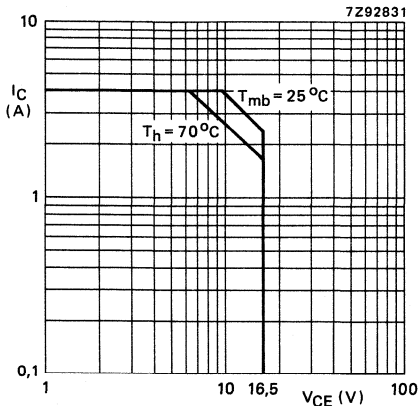


Fig. 2 D.C.SOAR.  
 $R_{th\ mb-h} = 0,2$  K/W

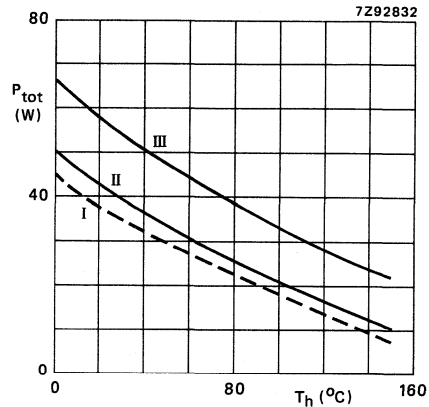


Fig. 3 Power/temperature derating curves  
I Continuous operation  
II Continuous operation ( $f > 1$  MHz)  
III Short-time operation during mismatch;  
( $f > 1$  MHz)

**THERMAL RESISTANCE** (dissipation = 37 W;  $T_{mb} = 25$  °C, i.e.  $T_h = 18$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(d.c.)}$	max	4,6 K/W
(r.f. dissipation)	$R_{th\ j-mb(r.f.)}$	max	4,1 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max	0,2 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage

$I_C = 25\text{ mA}$ ; open emitter

$V_{(BR)CBO} > 36\text{ V}$

Collector-emitter breakdown voltage

$I_C = 50\text{ mA}$ ; open base

$V_{(BR)CEO} > 16,5\text{ V}$

Emitter-base breakdown voltage

$I_E = 5\text{ mA}$ ; open collector

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0$ ;  $V_{CE} = 20\text{ V}$

$I_{CES} < 12,5\text{ mA}$

Second breakdown energy

$L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$ESBR > 5,3\text{ mJ}$

D.C. current gain

$I_C = 2,7\text{ A}$ ;  $V_{CE} = 10\text{ V}$

$h_{FE} > 15$   
typ. 60

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

$C_c$  typ. 53 pF

Feed-back capacitance at  $f = 1\text{ MHz}$

$I_C = 0$ ;  $V_{CE} = 12,5\text{ V}$

$C_{re}$  typ. 33 pF

Collector-flange capacitance

$C_{cf}$  typ. 3 pF

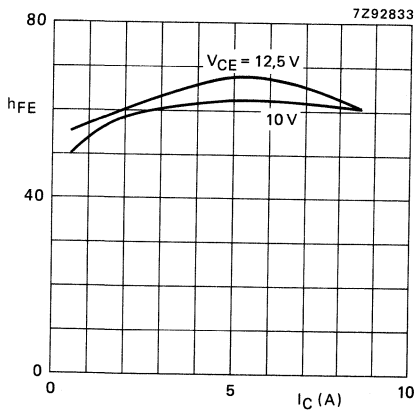


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ ; typ. values.

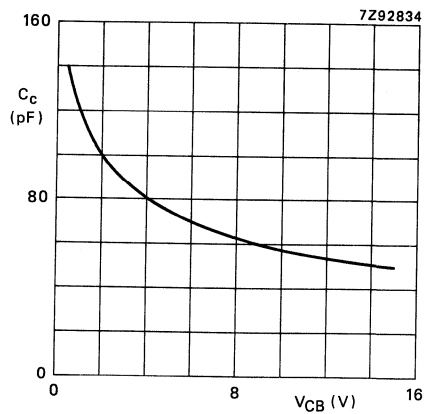


Fig. 5  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ; typ. values.

## APPLICATION INFORMATION

Mode of operation

in narrow band test circuit;  
class-B; c.w.

Collector-emitter voltage (d.c.)

 $V_{CE}$  12,5 V

Frequency

f 470 MHz

Load power

 $P_L$  20 W

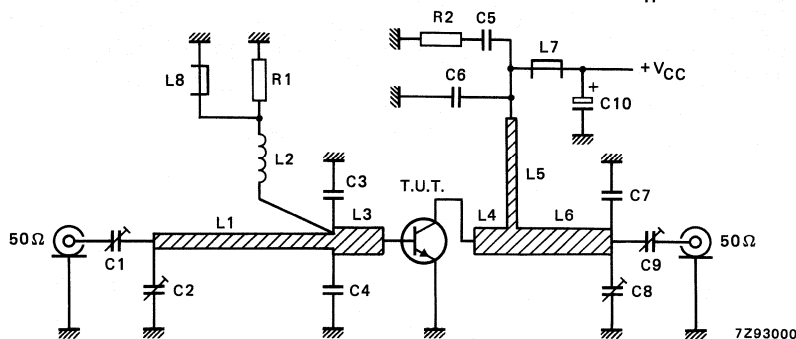
Power gain

 $G_p$  > 6,5 dB  
typ. 7,8 dB

Collector efficiency

 $\eta_c$  > 55 %  
typ. 64 %

Heatsink temperature

 $T_h$  25 °CFig. 6 Class-B test circuit at  $f = 470$  MHz.

## List of components:

C1 = C9 = 1,8 to 10 pF film dielectric trimmer (cat.no. 2222 809 05002)

C2 = 2 to 9 pF film dielectric trimmer (cat.no. 2222 809 09002)

C3 = C4 = 8,2 pF multilayer ceramic chip capacitor (100A type) \*

C5 = 100 nF polyester film capacitor

C6 = 120 pF multilayer ceramic chip capacitor

C7 = 8,2 pF multilayer ceramic chip capacitor (100B type) \*

C8 = 2 to 18 pF film dielectric trimmer (cat.no. 2222 809 09003)

C10 = 2,2  $\mu$ F electrolytic capacitorL1 = 50  $\Omega$  stripline (43,5 mm x 4,0 mm)

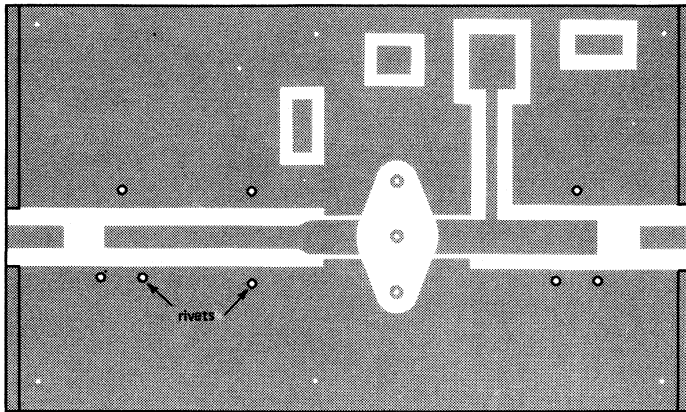
L2 = 100 nH; 5 turns closely wound enamelled Cu-wire (0,5 mm); int. diam. 4 mm; leads 2 x 5 mm

L3 = 37,6  $\Omega$  stripline (8,0 mm x 6,0 mm)L4 = 37,6  $\Omega$  stripline (9,0 mm x 6,0 mm)L5 = 74,4  $\Omega$  stripline (22,5 mm x 2,0 mm)L6 = 37,6  $\Omega$  stripline (18,0 mm x 6,0 mm)

L7 = L8 = Ferroxcube wideband h.f. choke, grade 3B (cat.no. 4312 020 36642)

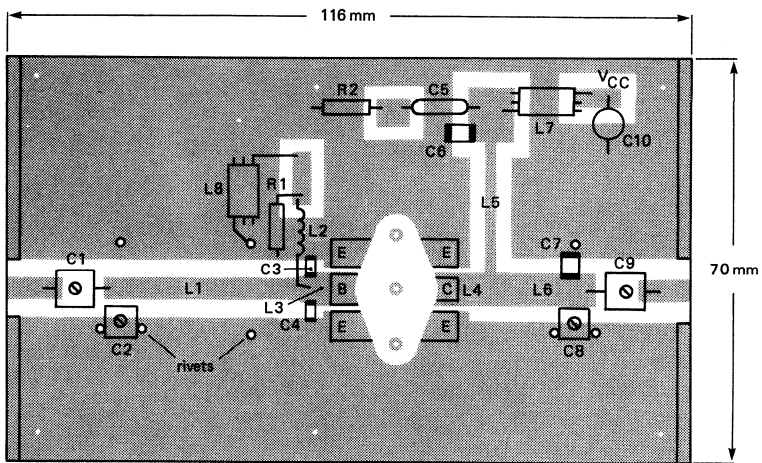
R1 = 1  $\Omega \pm 5\%$ ; 0,4 W metal film resistor (MR25 type)R2 = 10  $\Omega \pm 5\%$ ; 0,4 W metal film resistor (MR25 type)L1, L3, L4, L5 and L6 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16 inch.

\* American Technical Ceramics capacitor or capacitor of same quality.



7Z93002

Fig. 7 P.C. board for 470 MHz, class-B test circuit.



7Z93001

Fig. 8 Component lay-out of 470 MHz, class-B test circuit.

Note:

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as groundplane. Earth connections are made by hollow rivets and also by copper straps under the emitters and around the board to provide a direct contact between the copper on the component side and the ground plane.

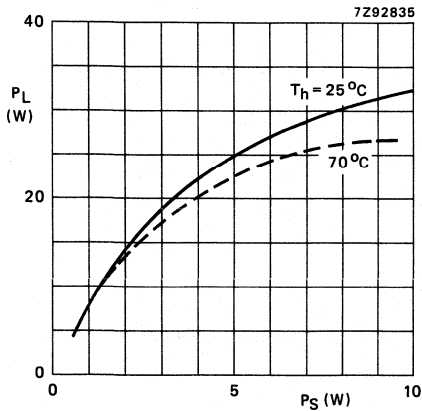


Fig. 9 Load power vs. source power.

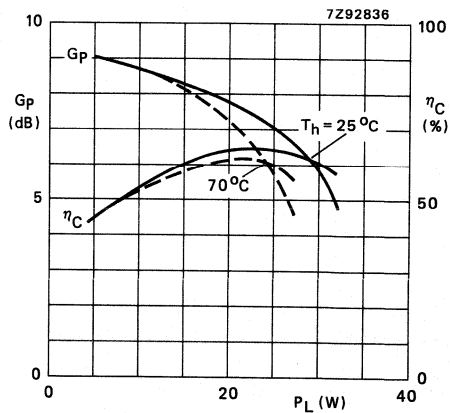


Fig. 10 Power gain and efficiency vs. load power.

Conditions for Figs. 9 and 10:

$V_{CE} = 12,5 \text{ V}$ ;  $f = 470 \text{ MHz}$ ; class-B operation;  $T_h = 25 \text{ }^\circ\text{C}$  and  $70 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ ; typical values.

### RUGGEDNESS

The device is capable of withstanding a full load mismatch (VSWR = 50; all phases) up to 25 W under the following conditions:

$V_{CE} = 15,5 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

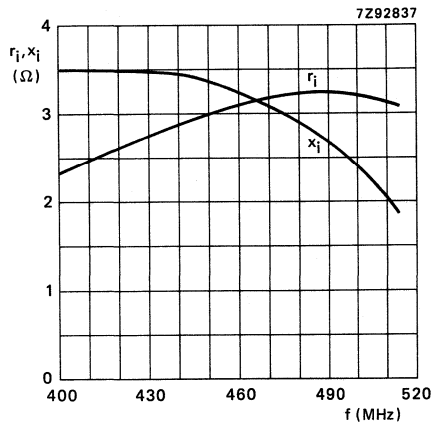


Fig. 11 Input impedance (series components).

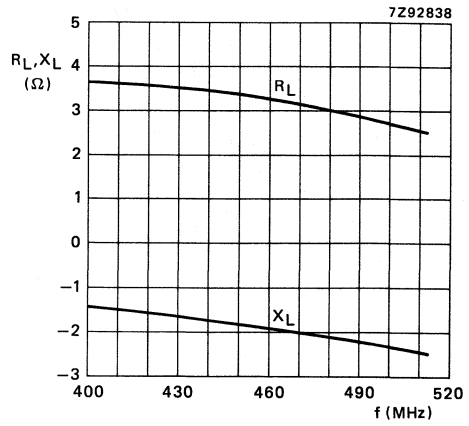


Fig. 12 Load impedance (series components).

Conditions for Figs. 11, 12 and 13:

$V_{CE} = 12,5 \text{ V}$ ;  $P_L = 20 \text{ W}$ ;  $f = 400\text{--}512 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ ; typical values.

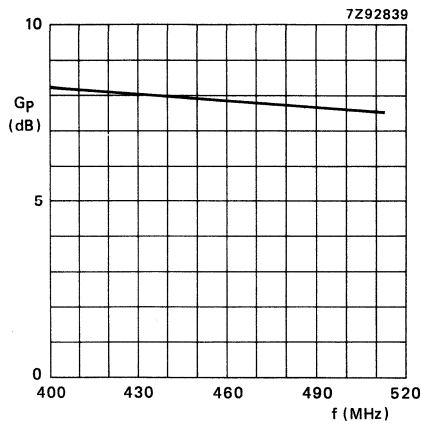


Fig. 13 Power gain versus frequency.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in mobile radio transmitters in the 470 MHz communications band.

### Features:

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability
- internal matching to achieve an optimum wideband capability and high power gain

The transistor has a 6-lead flange envelope with a ceramic cap (SOT-119). All leads are isolated from the flange.

### QUICK REFERENCE DATA

Envelope	SOT-119
Mode of operation	class-B; c.w.
Collector-emitter voltage (d.c.)	$V_{CE}$ 12,5 V
Frequency	$f$ 470 MHz
Load power	$P_L$ 30 W
Power gain	$G_p$ > 6,0 dB
Collector efficiency	$\eta_C$ > 55 %
Heatsink temperature	$T_h$ 25 °C

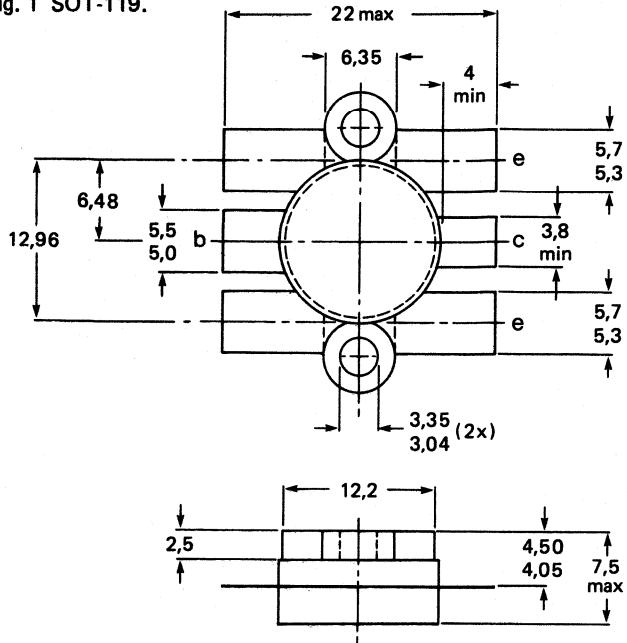
### MECHANICAL DATA

SOT-119 (see Fig. 1).

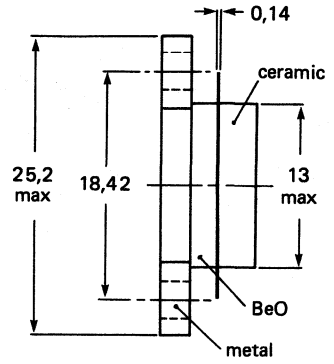
**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**MECHANICAL DATA**

Fig. 1 SOT-119.



**Dimensions in mm**



7277385.6

Torque on screw: min. 0,6 Nm (6 kg.cm)  
max. 0,75 Nm (7,5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16,5 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average (peak value); $f > 1$ MHz	$I_C$ $I_{CM}$	max.	6 A 18 A
Total power dissipation $f > 1$ MHz; $T_{mb} = 25$ °C	$P_{tot}$ (r.f.)	max.	65 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

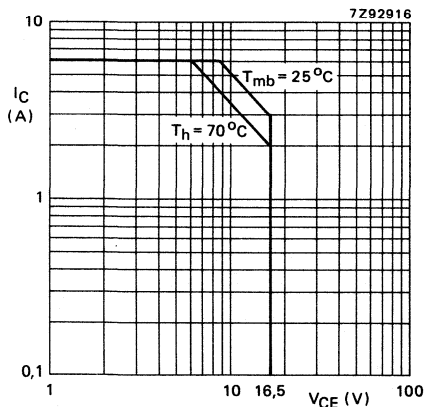


Fig. 2 D.C. SOAR.  
 $R_{th\ mb-h} = 0,2$  K/W

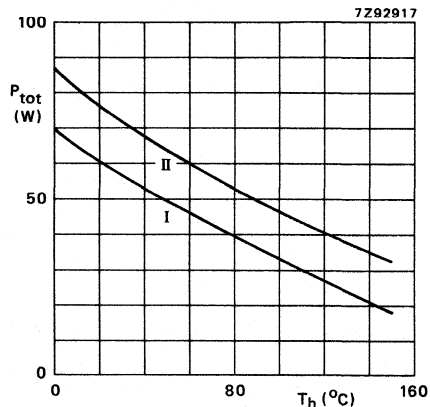


Fig. 3 Power/temperature derating curves  
I Continuous operation ( $f > 1$  MHz)  
II Short-time operation during mismatch;  
( $f > 1$  MHz)

**THERMAL RESISTANCE** (dissipation = 45 W;  $T_{mb} = 25$  °C).

From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(r.f.)}$	max.	2,45 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0,2 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage

$I_C = 50\text{ mA}$ ; open emitter

$V_{(BR)CBO} > 36\text{ V}$

Collector-emitter breakdown voltage

$I_C = 100\text{ mA}$ ; open base

$V_{(BR)CEO} > 16,5\text{ V}$

Emitter-base breakdown voltage

$I_E = 10\text{ mA}$ ; open collector

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

$I_{CES} < 22\text{ mA}$

Second breakdown energy

$L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$E_{SBR} > 8\text{ mJ}$

D.C. current gain

$I_C = 4\text{ A}$ ;  $V_{CE} = 10\text{ V}$

$h_{FE} > 15$   
typ. 60

Collector capacitance at  $f = 1\text{ MHz}$ \*

$I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

$C_c$  typ. 85 pF

Feed-back capacitance at  $f = 1\text{ MHz}$ \*

$I_C = 0$ ;  $V_{CE} = 12,5\text{ V}$

$C_{re}$  typ. 52 pF

Collector-flange capacitance

$C_{cf}$  typ. 3 pF

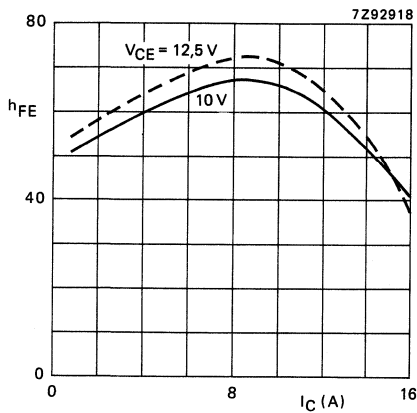


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ ; typ. values.

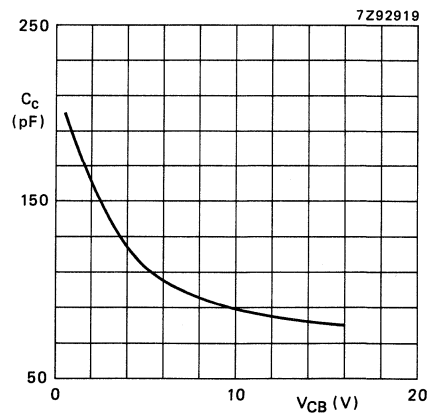


Fig. 5  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ; typ. values.

\* Device mounted in SOT-119 envelope without inputmatching.

## APPLICATION INFORMATION

Mode of operation

In narrow-band test circuit; class-B; c.w.

Collector-emitter voltage (d.c.)

 $V_{CE}$  12,5 V

Frequency

f 470 MHz

Load power

 $P_L$  30 W

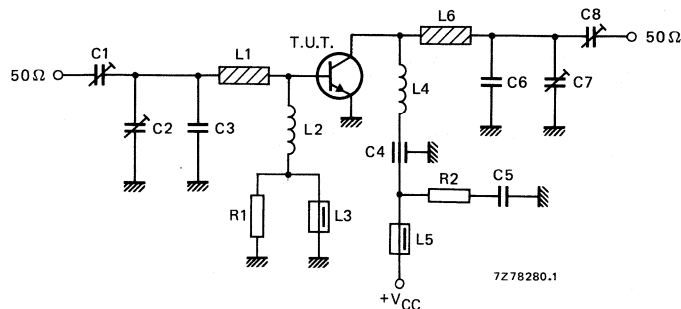
Power gain

 $G_p$  > 6,0 dB  
typ. 7,4 dB

Collector efficiency

 $\eta_C$  > 55 %  
typ. 66 %

Heatsink temperature

 $T_h$  25 °CFig. 6 Class-B test circuit at  $f = 470$  MHz.

## List of components:

C1 = C2 = C7 = C8 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C3 = C6 = 3,9 pF ceramic capacitor (500 V)

C4 = 100 pF feed-through capacitor

C5 = 100 nF polyester film capacitor

L1 = stripline (24,0 mm x 6,7 mm)

L2 = 10 turns closely wound enamelled Cu-wire (0,4 mm); int. diam. 4 mm

L3 = 2 turns enamelled Cu-wire (0,6 mm); Ferroxcube tube core, grade 3B5 (cat. no. 4313 020 15170)

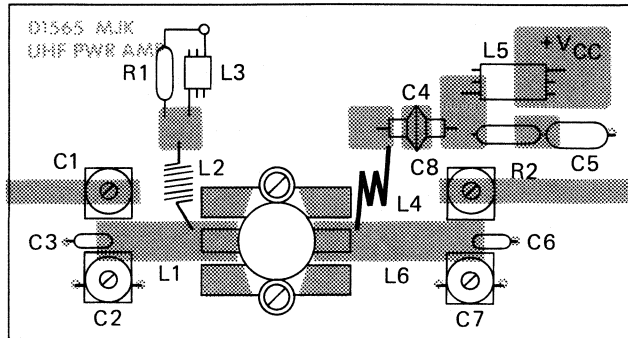
L4 = 12,6 nH; 2,5 turns enamelled Cu-wire (0,7 mm); int. diam. 4 mm; length 3 mm; leads 2 x 5 mm

L5 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)

L6 = stripline (28,4 mm x 6,7 mm)

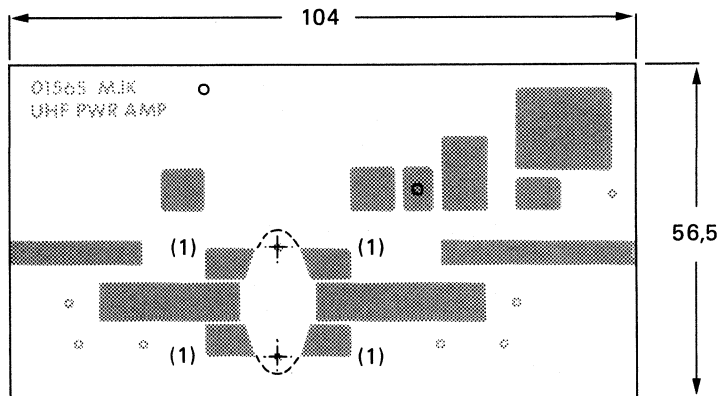
R1 = R2 = 10  $\Omega$  carbon resistorL1 and L6 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16 inch.

Component lay-out and printed-circuit board for 470 MHz test circuit are shown in Figs 7 and 8.



7Z78204.1

Fig. 7 Component lay-out of 470 MHz, class-B test circuit.



7Z78205.1

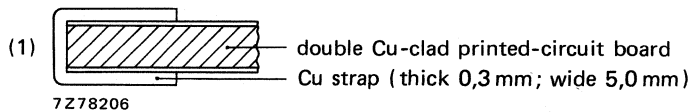


Fig. 8 P.c. board for 470 MHz, class-B test circuit.

Note:

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side fully metallized serving as groundplane. Earth connections are made by hollow rivets and also by copper straps under the emitter to provide a direct contact between the copper on the component side and the ground plane.

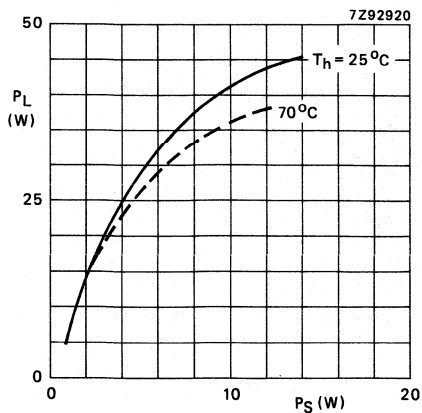


Fig. 9 Load power vs. source power.

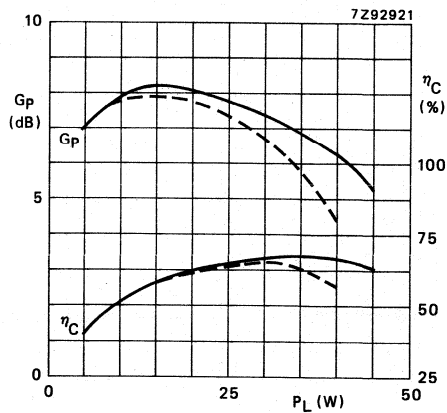


Fig. 10 Power gain and efficiency vs. load power.

—  $T_h = 25\text{ }^\circ\text{C}$ ;  
 - - -  $T_h = 70\text{ }^\circ\text{C}$ .

Conditions for Figs 9 and 10:

$V_{CE} = 12,5\text{ V}$ ;  $f = 470\text{ MHz}$ ; class-B operation;  $T_h = 25\text{ }^\circ\text{C}$  and  $70\text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0,2\text{ K/W}$ ; typical values.

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch ( $V_{SWR} = 50$ ; all phases) up to 38 W under the following conditions:

$V_{CE} = 15,5\text{ V}$ ;  $f = 470\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0,2\text{ K/W}$ .

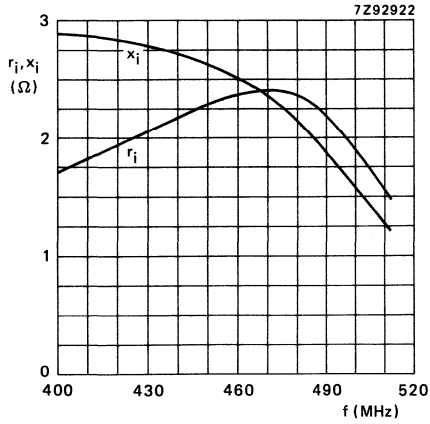


Fig. 11 Input impedance (series components).

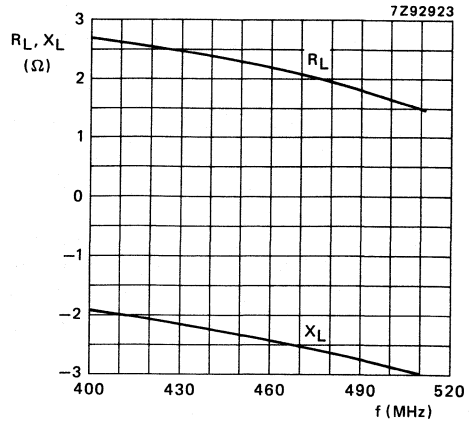


Fig. 12 Load impedance (series components).

Conditions for Figs 11, 12 and 13:

$V_{CE} = 12,5 \text{ V}$ ;  $P_L = 30 \text{ W}$ ;  $f = 400\text{--}512 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation;  $R_{th\text{ mb-h}} = 0,2 \text{ K/W}$ ; typical values.

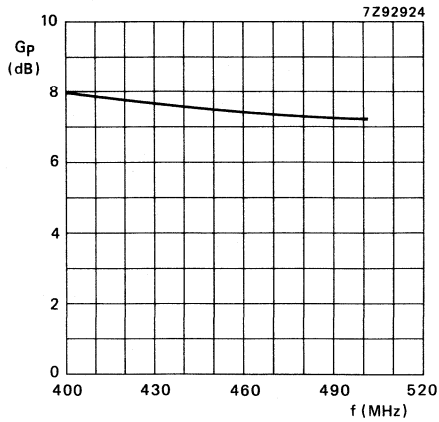


Fig. 13 Power gain versus frequency.



## UHF POWER TRANSISTOR

NPN silicon planar epitaxial transistor primarily intended for use in radio transmitters in the 470 MHz communications band.

### Features

- Multi-base structure and emitter ballasting resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability
- Internal matching to achieve an optimum wideband capability and high power gain

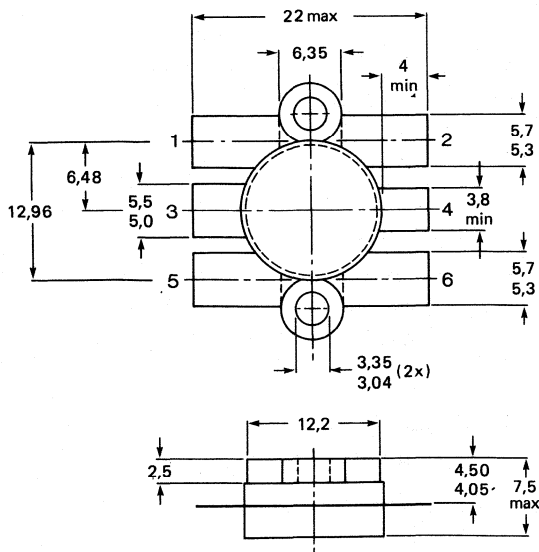
The BLU30/28 has a 6-lead flange envelope with a ceramic cap (SOT119). All leads are isolated from the flange.

### QUICK REFERENCE DATA

RF performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

Mode of operation	f MHz	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
CW class-B	470	28	30	> 8	> 55
CW class-B	470	24	25	typ. 8	typ. 60

### MECHANICAL DATA



### Lead reference

- 1 = emitter
- 2 = emitter
- 3 = base
- 4 = collector
- 5 = emitter
- 6 = emitter

7277385.7

Torque on screw: min. 0.6 Nm (6 kg cm)  
 max. 0.75 Nm (7.5 kg cm)  
 Recommended screw: cheese-head 4-40 UNC/2A  
 Heatsink compound must be applied sparingly, and evenly distributed.

Fig.1 SOT119.

**PRODUCT SAFETY:** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the internal BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak value), $V_{BE} = 0$ open base	$V_{CESM}$	max.	60 V
	$V_{CEO}$	max.	32 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3.5 V
Collector current DC or average	$I_C, I_{C(AV)}$	max.	4.0 A
peak value; $f > 1$ MHz	$I_{CM}$	max.	12 A
RF power dissipation $f > 1$ MHz; $T_{mb} = 25$ °C	$P_{rf}$	max.	65 W
Storage temperature range	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

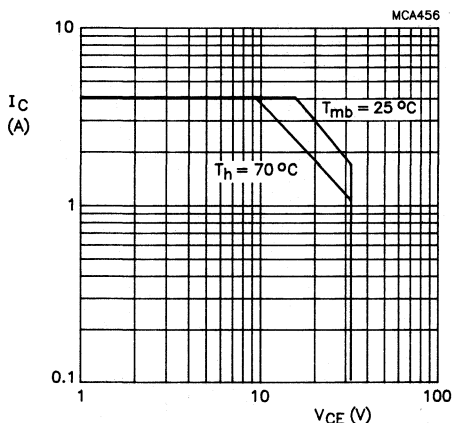
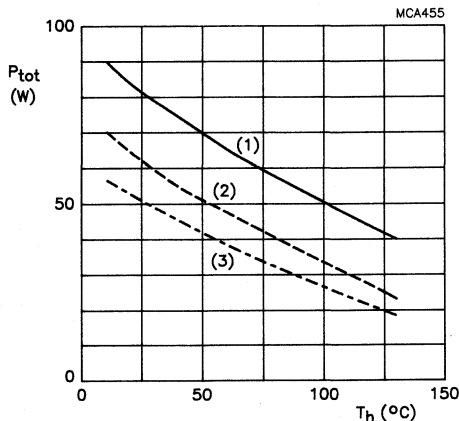


Fig.2 DC SOAR.



- (1) Short-time operation during mismatch.
- (2) Continuous RF operation ( $F > 1$  MHz).
- (3) Continuous DC operation.

Fig.3 Power/temperature derating curves.

**THERMAL RESISTANCE**

RF dissipation = 65 W;  $T_{mb} = 25$  °C

From junction to mounting base (rf)

From mounting base to heatsink

$R_{th\ j-mb}$  max. 2.55 K/W

$R_{th\ mb-h}$  max. 0.2 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 15\text{ mA}$   
open base;  $I_C = 100\text{ mA}$

$V_{(BR)CES}$  min. 60 V  
 $V_{(BR)CEO}$  min. 32 V

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO}$  min. 3.5 V

Collector cut-off current

$V_{BE} = 0; V_{CE} = 32\text{ V}$

$I_{CES}$  max. 5.0 mA

DC current gain

$I_C = 1.6\text{ A}; V_{CE} = 25\text{ V}$

$h_{FE}$  20 to 120  
typ. 75

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 28\text{ V}$

$C_c$  typ. 45 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 0; V_{CE} = 28\text{ V}$

$C_{re}$  typ. 28 pF

Collector-flange capacitance

$C_{cf}$  typ. 3.0 pF

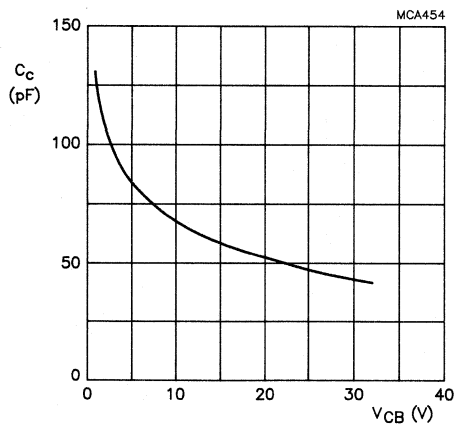
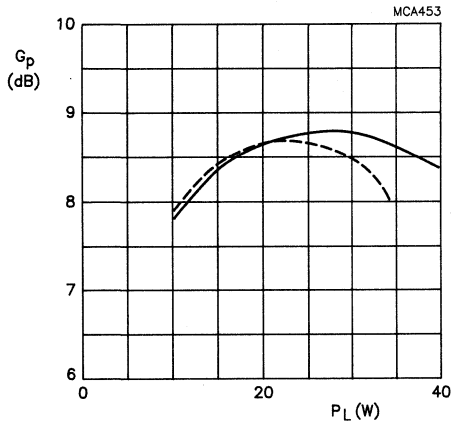


Fig.4 Collector capacitance as a function of base-collector voltage;  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

**APPLICATION INFORMATION**

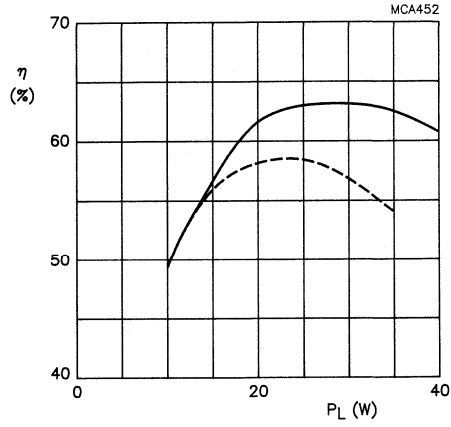
RF performance at  $T_h = 25\text{ }^\circ\text{C}$  in a class-B test circuit

Mode of operation	f MHz	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
CW class-B	470	28	30	> 8	> 55
CW class-B	470	24	25	typ. 8	typ. 60



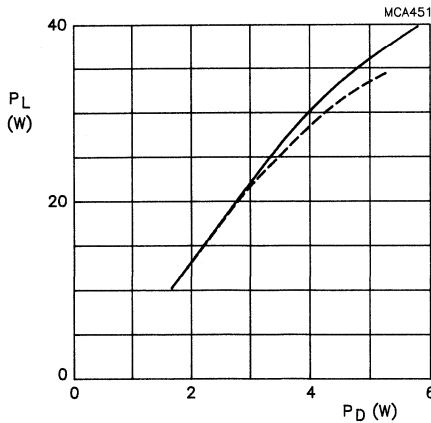
—  $T_h = 25\text{ }^\circ\text{C}$   
 - - -  $T_h = 70\text{ }^\circ\text{C}$

Fig.5 Power gain as a function of load power; typical values.



—  $T_h = 25\text{ }^\circ\text{C}$   
 - - -  $T_h = 70\text{ }^\circ\text{C}$

Fig.6 Efficiency as a function of load power; typical values.



—  $T_h = 25\text{ }^\circ\text{C}$   
 - - -  $T_h = 70\text{ }^\circ\text{C}$

Fig.7 Load power as a function of drive power; typical values.

**Conditions for Figs 5 to 7**

Class-B operation;  $V_{CE} = 28\text{ V}$ ;  $f = 470\text{ MHz}$ ;  $R_{th\text{ mb-h}} = 0.2\text{ K/W}$ .

**Ruggedness in class-B operation**

The BLU30/28 is capable of withstanding a load mismatch corresponding with  $V_{SWR} = 50$  through all phases under the following conditions:  $V_{CE} = 28 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0.2 \text{ K/W}$ , at rated output power.

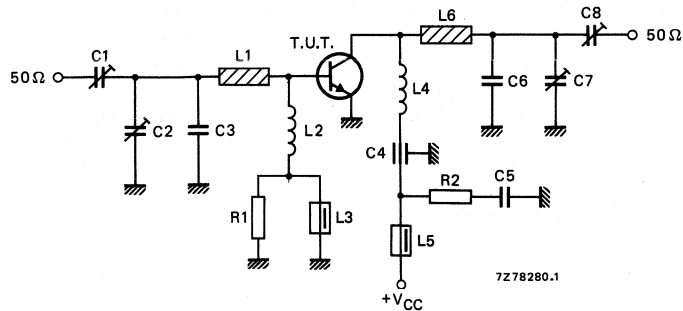


Fig.8 Class-B test circuit at  $f = 470 \text{ MHz}$ .

**List of components**

C1 = C2 = C7 = C8 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C3 = C6 = 3.9 pF ceramic capacitor (500 V)

C4 = 100 pF feed-through capacitor

C5 = 100 nF polyester film capacitor

L1 = stripline (24.0 mm x 6.7 mm)

L2 = 10 turns closely wound enamelled CU-wire (0.4 mm); int. diam. 4 mm

L3 = 2 turns enamelled Cu-wire (0.6 mm); Ferroxcube tube core, grade 3B5 (cat. no. 4313 020 15170)

L4 = 12.6 nH; 2.5 turns enamelled Cu-wire (0.7 mm); int. diam. 4 mm; length 3 mm; leads 2 x 5 mm

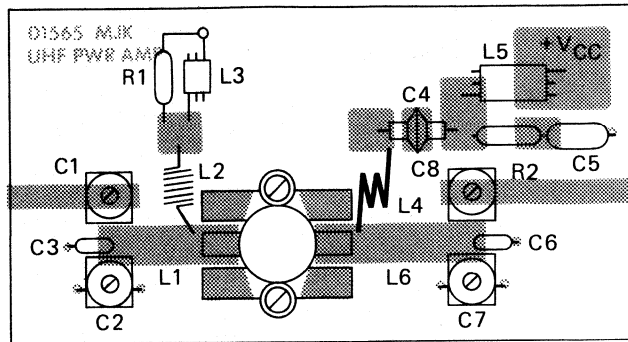
L5 = Ferroxcube wideband HF choke, grade 3B (cat. no. 4312 020 36642)

L6 = stripline (28.4 mm x 6.7 mm)

R1 = R2 = 10 Ω carbon resistor

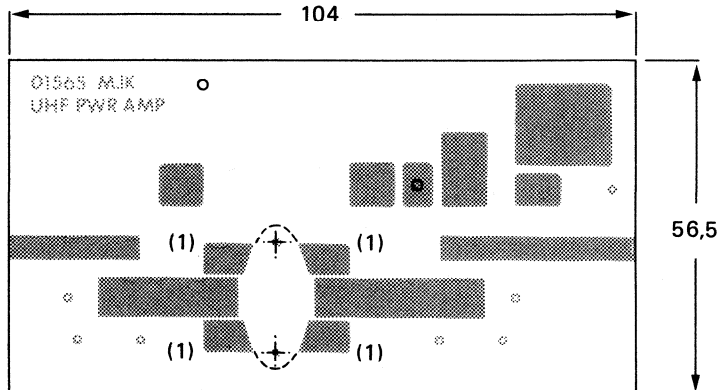
L1 and L6 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric; thickness 1/16 inch; ( $\epsilon_r = 2.74$ ).

APPLICATION INFORMATION (continued)

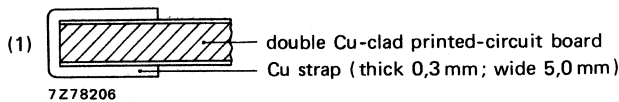


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Fig.9 Component layout of 470 MHz, class-B test circuit.



7Z78205.1



7Z78206

Fig.10 Printed-circuit board for 470 MHz, class-B test circuit.

NOTE

The circuit and the components are on one side of the PTFE fibre-glass board; the other side is fully metallized serving as groundplane. Earth connections are made by hollow rivets and also by copper straps under the emitter to provide a direct contact between the copper on the component side and the ground plane.

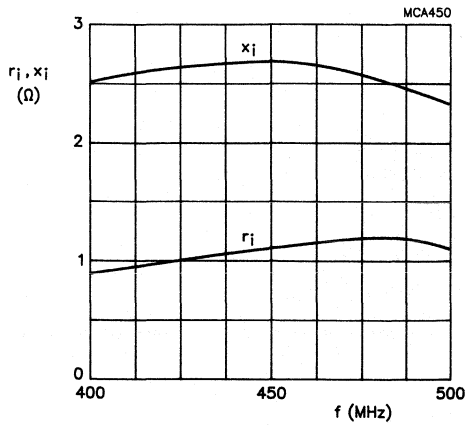


Fig.11 Input impedance as a function of frequency (series components); typical values.

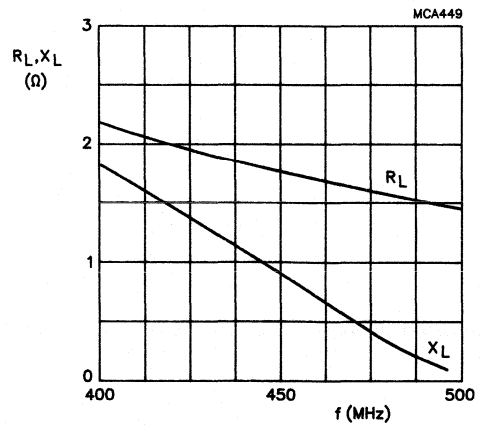


Fig.12 Load impedance as a function of frequency (series components); typical values.

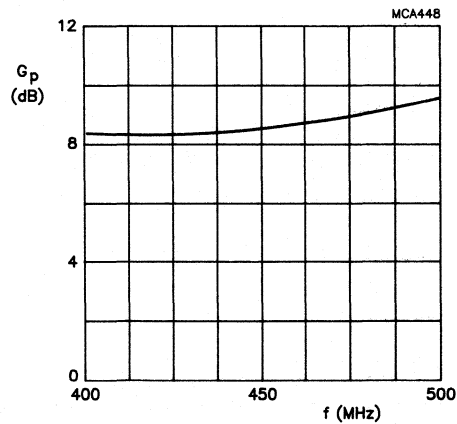


Fig.13 Power gain as a function of frequency; typical values.

**Conditions for Figs 11 to 13**

Class-B operation;  $V_{CE} = 28$  V;  $P_L = 30$  W;  $R_{th\ mb-h} = 0.2$  K/W.





## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor in SOT-119 envelope primarily intended for use in mobile radio transmitters in the 470 MHz communications band.

### Features

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile.
- internal matching to achieve an optimum wideband capability and high power gain.
- gold metallization ensures excellent reliability.

The transistor has a 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	470	45	> 4,8	> 55

### MECHANICAL DATA

SOT-119 (see Fig. 1).

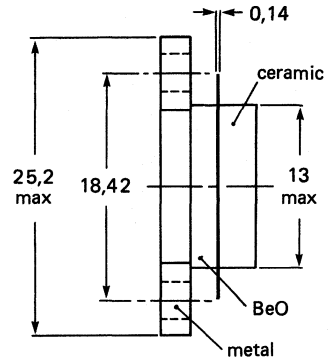
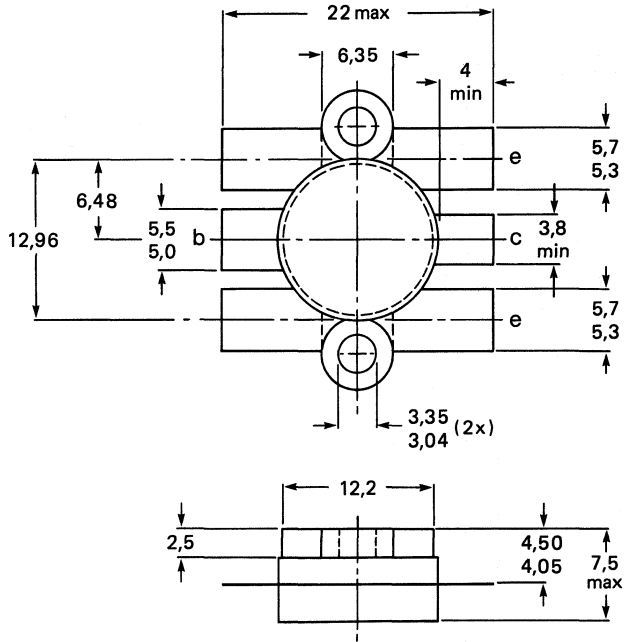
Dimensions in mm

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-119

Dimensions in mm



7277385.6

Torque on screw: min. 0,6 Nm (6 kg.cm)  
max. 0,75 Nm (7,5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16,5 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average	$I_C$	max.	9 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	27 A
Total power dissipation at $T_{mb} = 25\text{ }^\circ\text{C}$ ; $f > 1$ MHz	$P_{tot}$	max.	87 W
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Operating junction temperature	$T_j$	max.	200 $^\circ\text{C}$

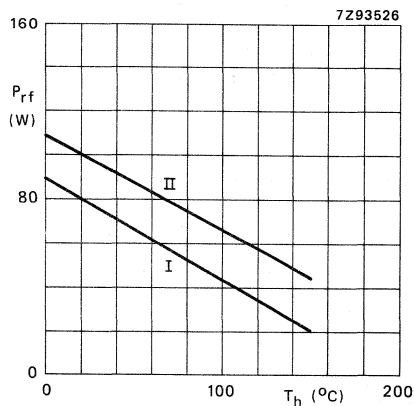


Fig. 2 Power/temperature derating curves.

- I Continuous operation ( $f > 1$  MHz).
- II Short-time operation during mismatch ( $f > 1$  MHz).

**MAXIMUM THERMAL RESISTANCE**

Dissipation = 54 W;  $T_{amb} = 25\text{ }^\circ\text{C}$

From junction to mounting base (r.f. operation)	$R_{th\ j-mb}$	max.	1,7 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0,2 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 100\text{ mA}$

$V_{(BR)CBO}$  min. 36 V

Collector-emitter breakdown voltage  
open base;  $I_C = 200\text{ mA}$

$V_{(BR)CEO}$  min. 16,5 V

Emitter-base breakdown voltage  
open collector;  $I_E = 20\text{ mA}$

$V_{(BR)EBO}$  min. 4 V

Collector cut-off current  
 $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

$I_{CES}$  max. 44 mA

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$E_{SBR}$  min. 15 mJ

D.C. current gain  
 $V_{CE} = 10\text{ V}$ ;  $I_C = 8\text{ A}$

$h_{FE}$  min. 15  
typ. 60

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

$C_c$  typ. 170 pF

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0$ ;  $V_{CE} = 12,5$

$C_{re}$  typ. 100 pF

Collector-flange capacitance

$C_{cf}$  typ. 3 pF

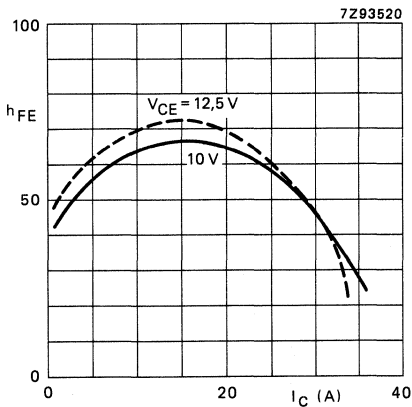


Fig. 3 D.C. current gain versus collector current;  $T_j = 25\text{ }^\circ\text{C}$ .

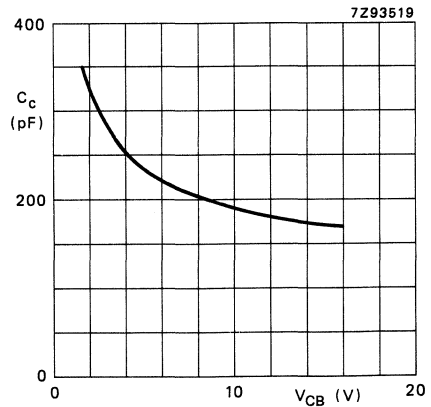
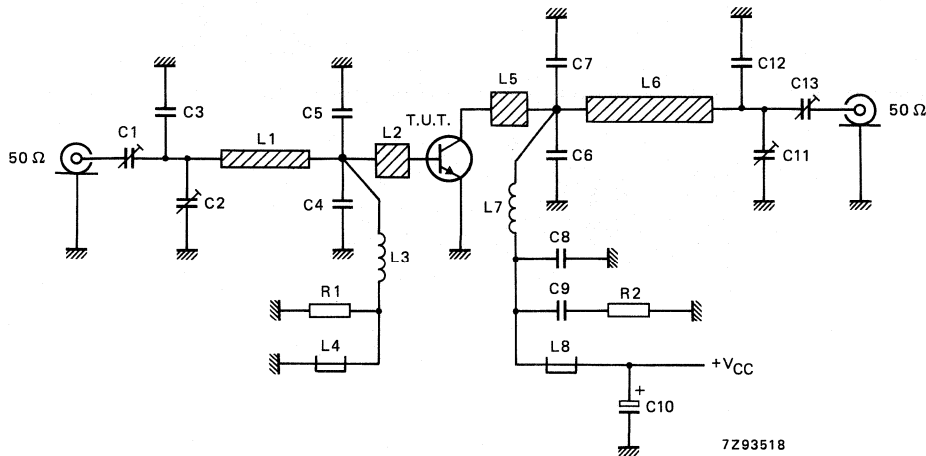


Fig. 4 Output capacitance versus  $V_{CB}$ ;  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ .

## APPLICATION INFORMATION

R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	470	45	> 4,8 typ. 5,8	> 55 typ. 61

Fig. 5 Class-B test circuit at  $f = 470\text{ MHz}$ .

List of components:

C1 = C13 = 1,8 to 10 pF film dielectric trimmer (cat. no. 2222 809 05002)

C2 = C11 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C3 = 12 pF multilayer ceramic chip capacitor\*

C4 = C5 = 8,2 pF multilayer ceramic chip capacitor\*\*

C6 = C7 = 15 pF multilayer ceramic chip capacitor\*

C8 = 110 pF multilayer ceramic chip capacitor\*

C9 = 3 x 100 nF multilayer ceramic chip capacitor in parallel

C10 = 2,2  $\mu\text{F}$  (35 V) electrolytic capacitor

C12 = 5,6 pF multilayer ceramic chip capacitor\*

L1 = 34,6  $\Omega$  stripline (17 mm x 4 mm)L2 = L5 = 25,3  $\Omega$  stripline (6 mm x 6 mm)

L3 = 45 nH; 4 turns, closely wound enamelled Cu-wire (0,5 mm); int. dia. 2,5 mm; leads 2 x 5 mm

L4 = L8 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)

L6 = 29,2  $\Omega$  stripline (25,5 mm x 5 mm)

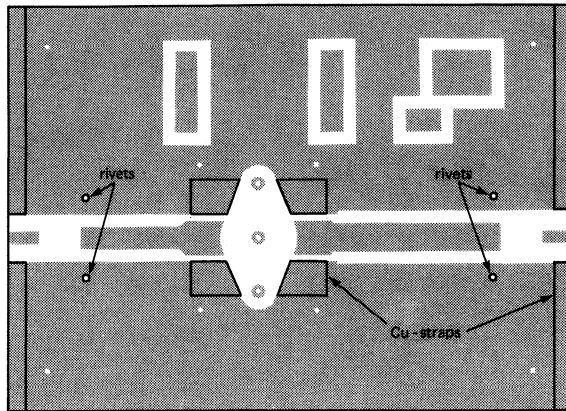
L7 = 10 nH; 1 turn Cu-wire (1,0 mm); int. dia. 5 mm; leads 2 x 5 mm

R1 = 1  $\Omega \pm 5\%$  (0,4 W) metal film resistorR2 = 10  $\Omega \pm 5\%$  (1,0 W) metal film resistor

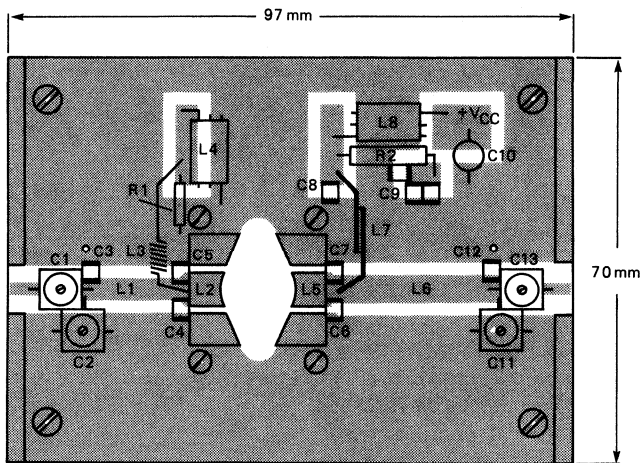
\* American Technical Ceramics capacitor type B or capacitor of the same quality.

\*\* Idem type A.

Striplines are on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $E_r = 2,2$ ); thickness 1/32 inch.



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7293517

Fig. 6 Printed circuit board and component layout for 470 MHz class-B test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board; the other side is unetched copper serving as a ground plane. Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the bases to provide a direct contact between the copper on the component side and the ground plane.

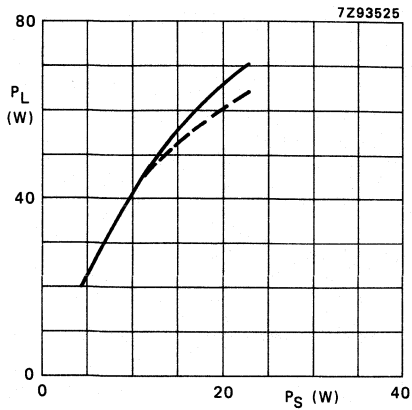


Fig. 7 Load power versus source power.

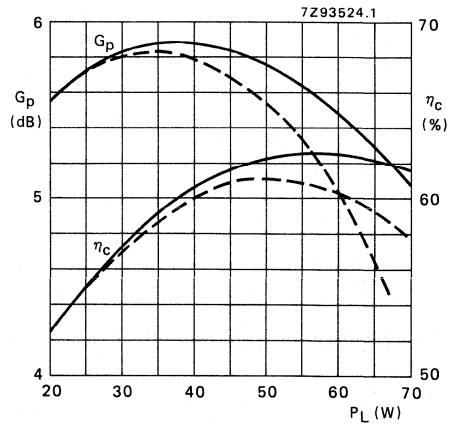


Fig. 8 Power gain and efficiency versus load power.

Conditions for Figs 7 and 8:

Typical values;  $V_{CE} = 12,5 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$  (—) and  $70 \text{ }^\circ\text{C}$  (---);

$R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ ; class-B operation.

### RUGGEDNESS

The BLU45/12 is capable of withstanding a full load mismatch (VSWR = 50 through all phases) up to 55 W under the following conditions:  $V_{CE} = 15,5 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

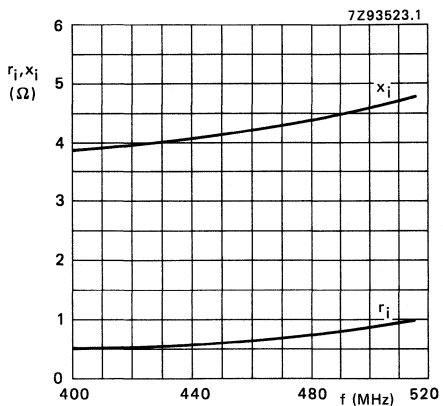


Fig. 9 Input impedance (series components).

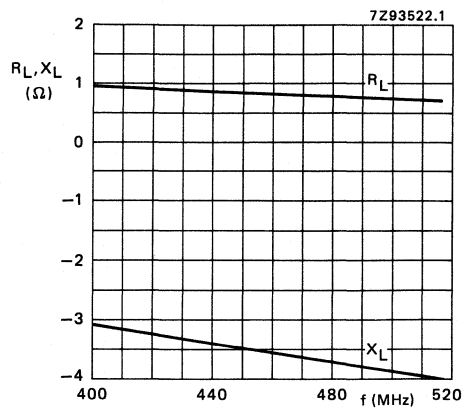


Fig. 10 Load impedance (series components).

Conditions for Figs 9, 10 and 11 (class-B operation):

Typical values;  $V_{CE} = 12,5 \text{ V}$ ;  $P_L = 45 \text{ W}$ ;  $f = 400 \text{ to } 512 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  
 $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

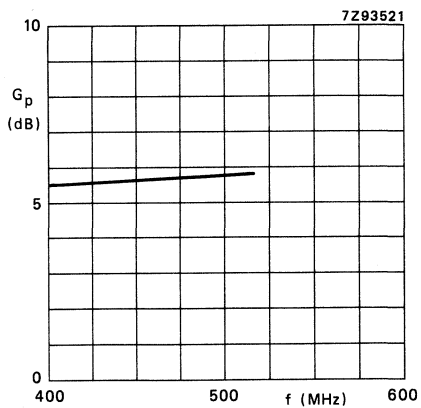


Fig. 11 Power gain versus frequency.



Data sheet	
status	Product specification
date of issue	January 1991

# BLU56

## UHF power transistor

### FEATURES

- SMD encapsulation
- Emitter-ballasting resistors for optimum temperature profile
- Gold metallization ensures excellent reliability.

### DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a SOT223 surface mounted envelope and designed primarily for use in mobile radio equipment in the 470 MHz communications band.

### PINNING - SOT223

PIN	DESCRIPTION
1	emitter
2	base
3	emitter
4	collector

### QUICK REFERENCE DATA

RF performance at  $T_s \leq 60^\circ\text{C}$  in a common emitter class-B test circuit (see note 1.)

MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$G_p$ (dB)	$\eta_c$ (%)
c.w. narrow band	470	12.5	1	> 12	> 50

### Note

1.  $T_s$  = temperature at soldering point of collector tab.

### PIN CONFIGURATION

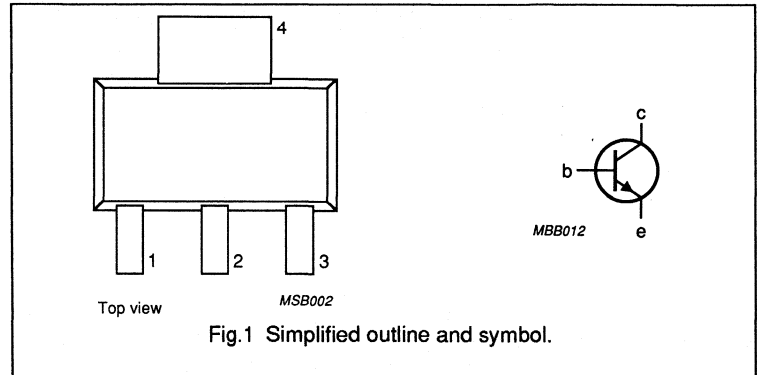


Fig.1 Simplified outline and symbol.

# UHF power transistor

**BLU56**

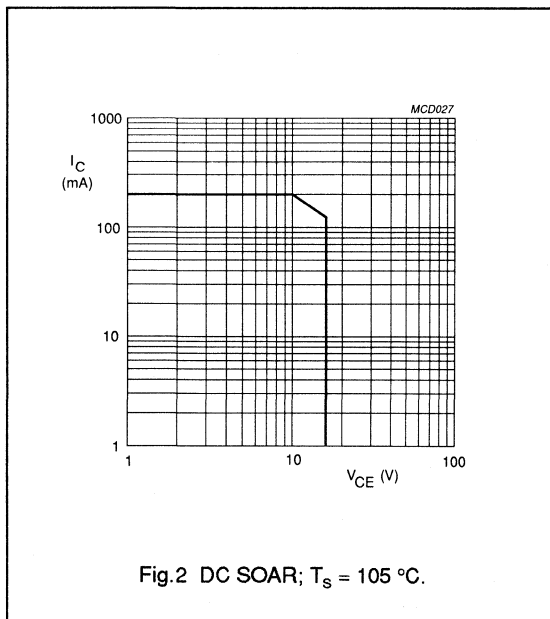
## LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	–	36	V
$V_{CEO}$	collector-emitter voltage	open base	–	16	V
$V_{EBO}$	emitter-base voltage	open collector	–	3	V
$I_C, I_{C(AV)}$	collector current	DC or average value	–	200	mA
$I_{CM}$	collector current	peak value $f > 1$ MHz	–	600	mA
$P_{tot}$	total power dissipation	$f > 1$ MHz $T_s = 105$ °C (note 1)	–	2	W
$T_{stg}$	storage temperature range		–65	150	°C
$T_j$	operating junction temperature		–	175	°C

### Note

- $T_s$  = temperature at soldering point of collector tab.



## THERMAL RESISTANCE

SYMBOL	PARAMETER	MAX.	UNIT
$R_{th j-s(DC)}$	from junction to soldering point	35	K/W

# UHF power transistor

# BLU56

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ .

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter $I_C = 2.5\text{ mA}$	36	—	—	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base $I_C = 10\text{ mA}$	16	—	—	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector $I_E = 0.5\text{ mA}$	3	—	—	V
$I_{CES}$	collector-emitter leakage current	$V_{BE} = 0$ $V_{CE} = 16\text{ V}$	—	—	1	mA
$h_{FE}$	DC current gain	$V_{CE} = 10\text{ V}$ $I_C = 150\text{ mA}$	25	—	—	
$E_{SBR}$	second breakdown energy	$L = 25\text{ mH}$ $R_{BE} = 10\text{ }\Omega$ $f = 50\text{ Hz}$	0.3	—	—	mJ
$C_c$	collector capacitance	$V_{CB} = 12.5\text{ V}$ $I_E = I_o = 0$ $f = 1\text{ MHz}$	—	2.2	3	pF
$C_{re}$	feedback capacitance	$V_{CE} = 12.5\text{ V}$ $I_C = 0$ $f = 1\text{ MHz}$	—	1.2	2	pF

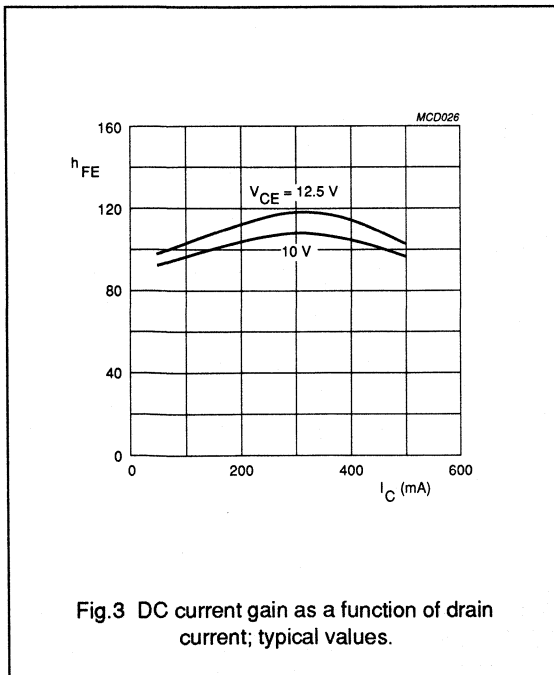


Fig.3 DC current gain as a function of drain current; typical values.

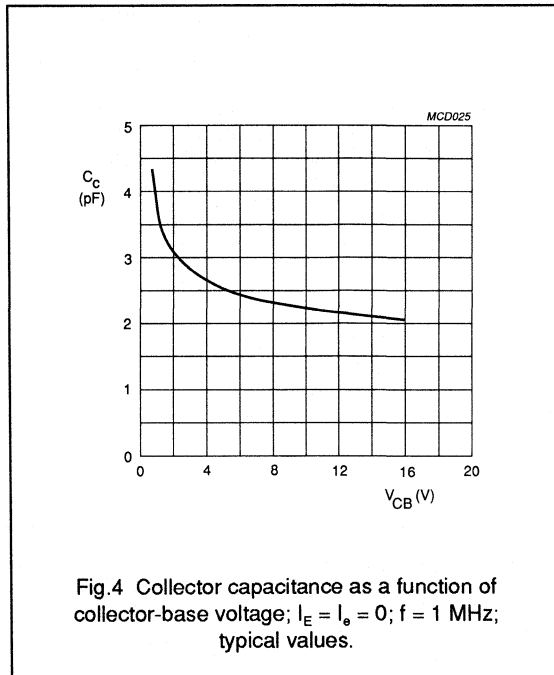


Fig.4 Collector capacitance as a function of collector-base voltage;  $I_E = I_o = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

## UHF power transistor

BLU56

## APPLICATION INFORMATION

RF performance at  $T_s \leq 60^\circ\text{C}$ ; in a common emitter class-B test circuit.

MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$G_p$ (dB)	$\eta_c$ (%)
c.w. narrow band	470	12.5	1	> 12 typ. 14	> 50 typ. 58

## Ruggedness in class-B operation

The BLU56 is capable of withstanding a load mismatch corresponding to  $VSWR = 50:1$  through all phases at rated output power, up to a supply voltage of 15.5 V,  $f = 470$  MHz and  $T_s \leq 60^\circ\text{C}$ .

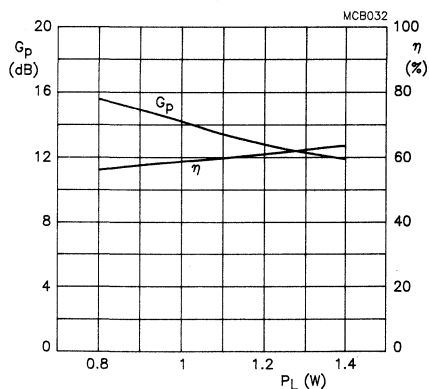


Fig.5 Gain and efficiency as functions of load power; typical values.

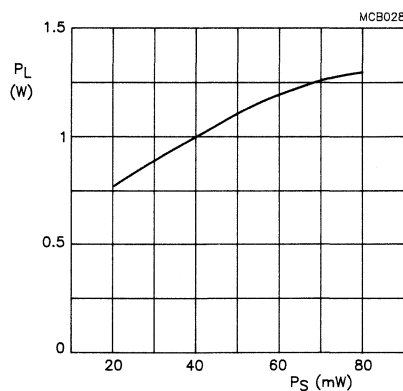
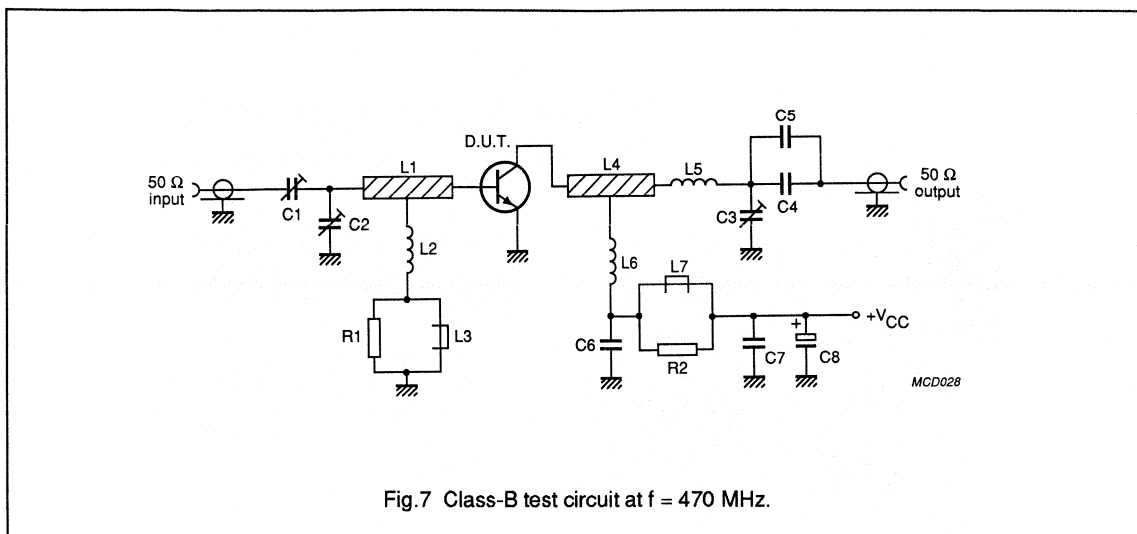


Fig.6 Load power as a function of drive power; typical values.

## UHF power transistor

BLU56

Fig.7 Class-B test circuit at  $f = 470$  MHz.

## List of components (see test circuit)

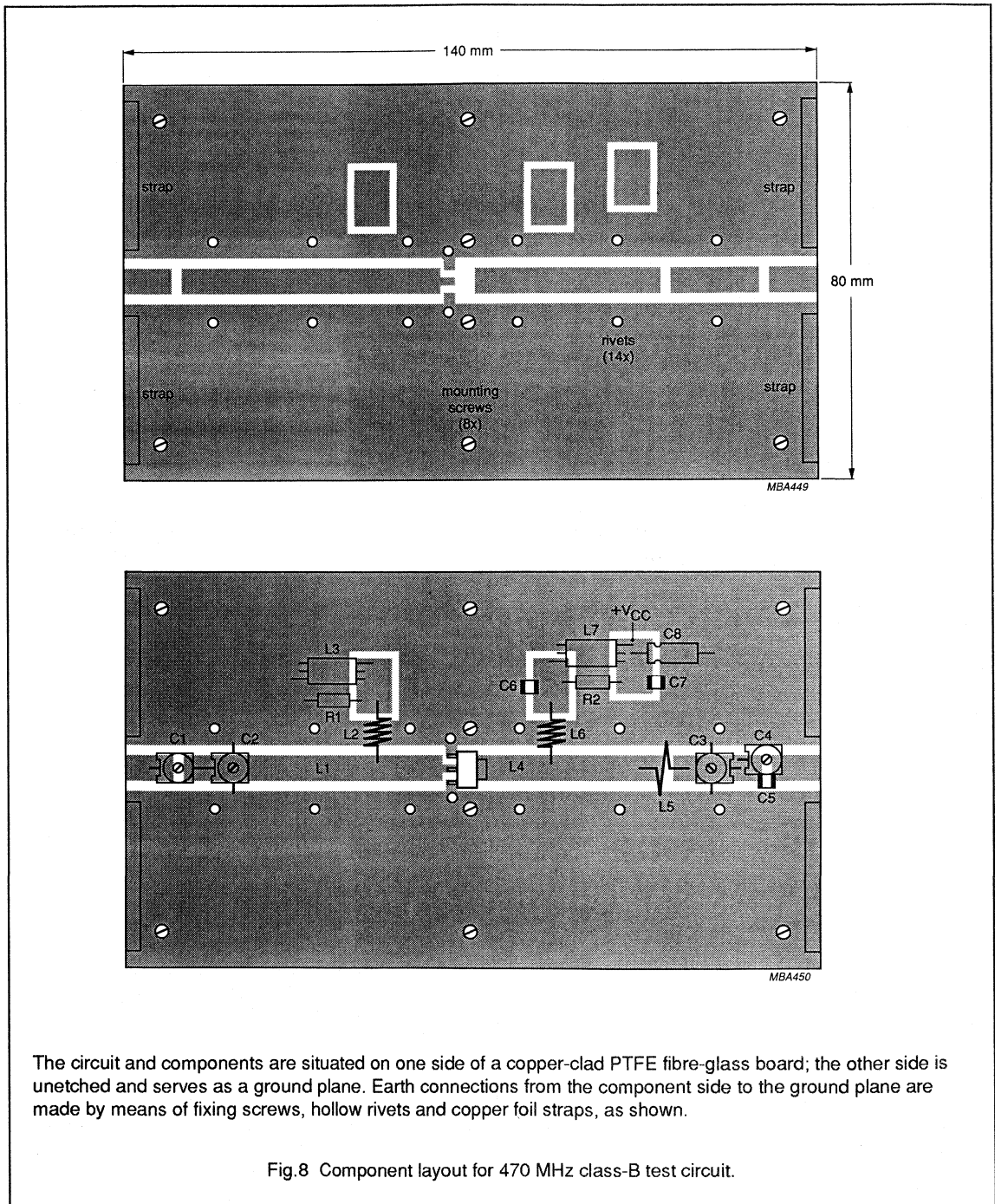
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C4	film dielectric trimmer	2 to 18 pF		2222 809 05217
C2, C3	film dielectric trimmer	2 to 9 pF		2222 809 09002
C5	multilayer ceramic chip capacitor (note 1)	10 pF		
C6	multilayer ceramic chip capacitor (note 1)	100 pF		
C7	multilayer ceramic chip capacitor (note 1)	1 nF		
C8	63 V electrolytic capacitor	2.2 $\mu$ F		
L1	stripline (note 2)	50 $\Omega$	54 mm x 4.7 mm	
L2, L6	4 turns enamelled 0.4 mm copper wire	50 nH	int. dia. 3 mm	
L3, L7	grade 3B1 Ferroxcube wideband RF choke			4312 020 36640
L4	stripline (note 2)	50 $\Omega$	36 mm x 4.7 mm	
L5	1 turn enamelled 2.2 mm copper wire	20 nH	int. dia. 8 mm	
R1, R2	0.25 W metal film resistor	10 $\Omega$ , 5%		

## Notes

- American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.
- The striplines are mounted on a double copper-clad printed circuit board, with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness  $\frac{1}{16}$  inch.

## UHF power transistor

BLU56



The circuit and components are situated on one side of a copper-clad PTFE fibre-glass board; the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by means of fixing screws, hollow rivets and copper foil straps, as shown.

Fig.8 Component layout for 470 MHz class-B test circuit.

**UHF power transistor**

**BLU56**

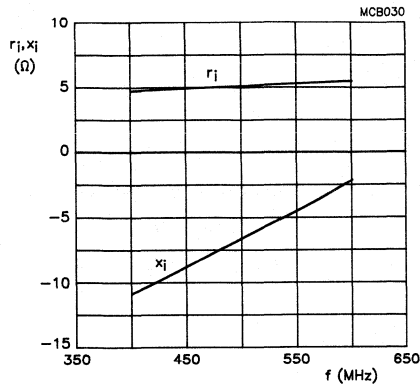


Fig. 9 Input impedance (series components) as a function of frequency; class-B operation;  $V_{CE} = 12.5$  V;  $P_L = 1$  W; typical values.

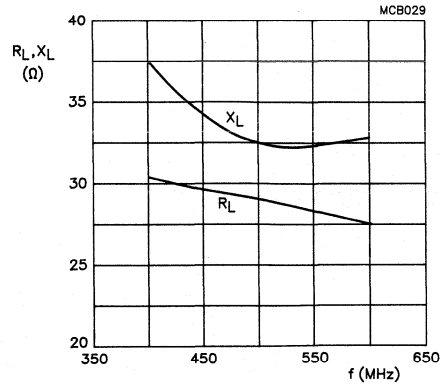


Fig. 10 Load impedance (series components) as a function of frequency; class-B operation;  $V_{DS} = 12.5$  V;  $P_L = 1$  W; typical values.

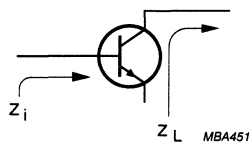


Fig. 11 Definition of transistor impedance.

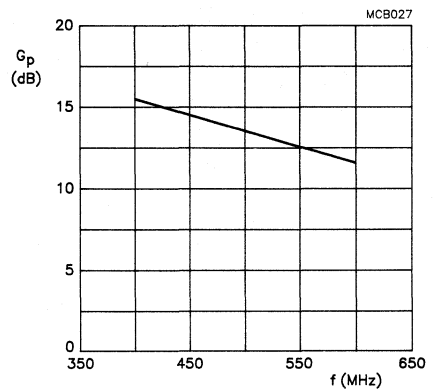
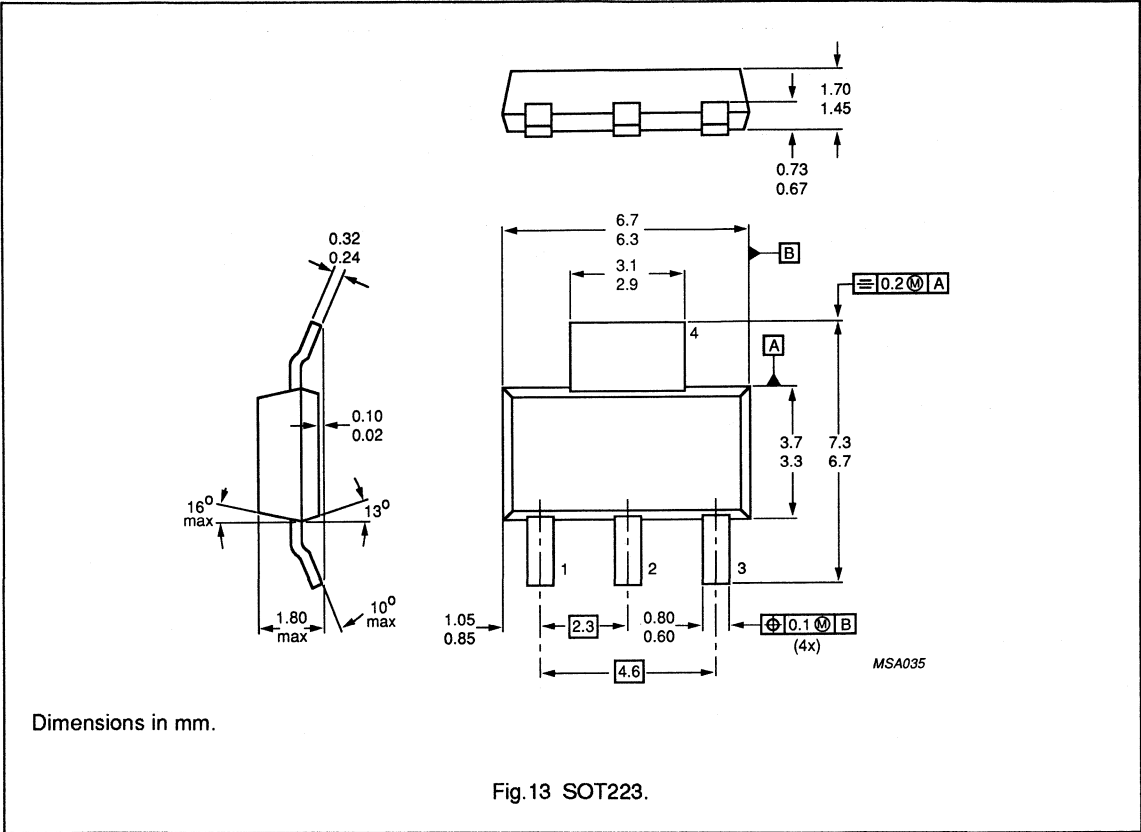


Fig. 12 Power gain as a function of frequency; class-B operation;  $V_{DS} = 12.5$  V;  $P_L = 1$  W; typical values.

UHF power transistor

BLU56

PACKAGE OUTLINE



Dimensions in mm.

Fig.13 SOT223.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor in SOT-119 envelope primarily intended for use in mobile radio transmitters in the 470 MHz communications band.

### Features

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile.
- internal matching to achieve an optimum wideband capability and high power gain.
- gold metallization ensures excellent reliability.

The transistor has a 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	470	60	> 4,4	> 55

### MECHANICAL DATA

SOT-119 (see Fig. 1).

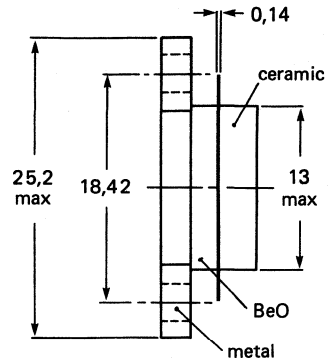
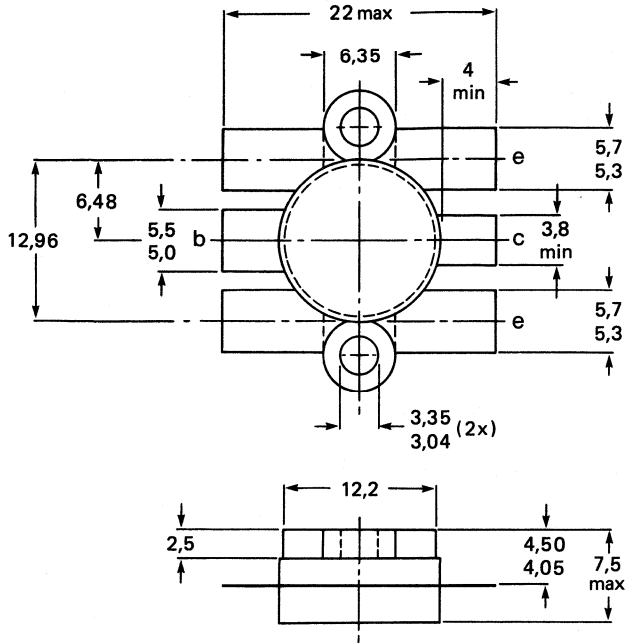
Dimensions in mm

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-119.

Dimensions in mm



7277385.6

Torque on screw: min. 0,6 Nm (6 kg.cm)  
max. 0,75 Nm (7,5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16,5 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average	$I_C$	max.	12 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	36 A
Total power dissipation at $T_{mb} = 25\text{ }^\circ\text{C}$ ; $f > 1$ MHz	$P_{tot}$	max.	110 W
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Operating junction temperature	$T_j$	max.	200 $^\circ\text{C}$

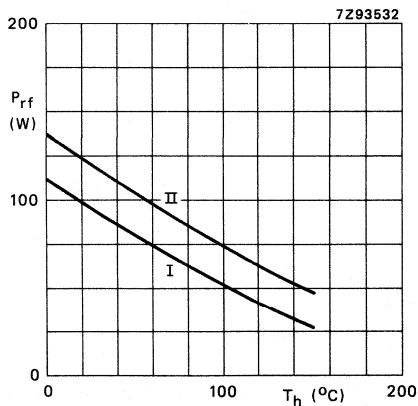


Fig. 2 Power/temperature derating curves.

- I Continuous operation ( $f > 1$  MHz).
- II Short-time operation during mismatch ( $f > 1$  MHz).

**MAXIMUM THERMAL RESISTANCE**

Dissipation = 72 W;  $T_{amb} = 25\text{ }^\circ\text{C}$

From junction to mounting base (r.f. operation)	$R_{th\ j-mb}$	max.	1,4 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0,2 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 100\text{ mA}$

$V_{(BR)CBO}$  min. 36 V

Collector-emitter breakdown voltage  
open base;  $I_C = 200\text{ mA}$

$V_{(BR)CEO}$  min. 16,5 V

Emitter-base breakdown voltage  
open collector;  $I_E = 20\text{ mA}$

$V_{(BR)EBO}$  min. 4 V

Collector cut-off current  
 $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

$I_{CES}$  max. 44 mA

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$E_{SBR}$  min. 15 mJ

D.C. current gain  
 $V_{CE} = 10\text{ V}$ ;  $I_C = 8\text{ A}$

$h_{FE}$  min. 15  
typ. 60

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

$C_c$  typ. 170 pF

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0$ ;  $V_{CE} = 12,5$

$C_{re}$  typ. 100 pF

Collector-flange capacitance

$C_{cf}$  typ. 3 pF

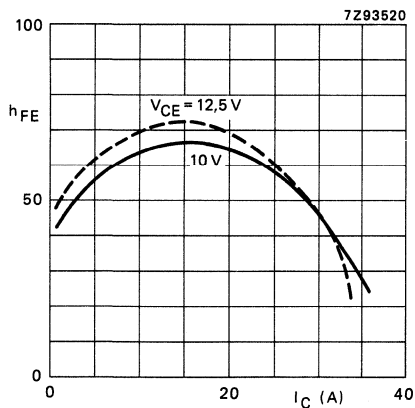


Fig. 3 D.C. current gain versus collector current;  $T_j = 25\text{ }^\circ\text{C}$ .

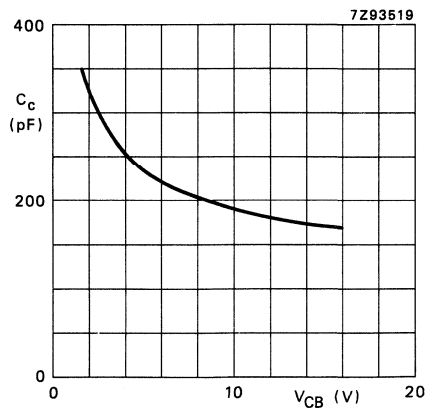
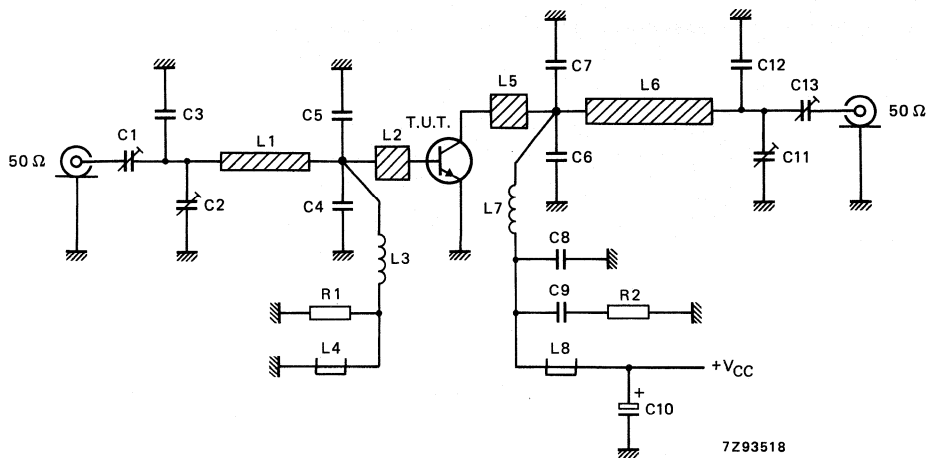


Fig. 4 Output capacitance versus  $V_{CB}$ ;  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ .

## APPLICATION INFORMATION

R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	470	60	> 4,4 typ. 5,5	> 55 typ. 62

Fig. 5 Class-B test circuit at  $f = 470\text{ MHz}$ .

## List of components:

- C1 = C13 = 1,8 to 10 pF film dielectric trimmer (cat. no. 2222 809 05002)
- C2 = C11 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C3 = 12 pF multilayer ceramic chip capacitor\*
- C4 = C5 = 8,2 pF multilayer ceramic chip capacitor\*\*
- C6 = C7 = 15 pF multilayer ceramic chip capacitor\*
- C8 = 110 pF multilayer ceramic chip capacitor\*
- C9 = 3 × 100 nF multilayer ceramic chip capacitor in parallel
- C10 = 2,2 μF (35 V) electrolytic capacitor
- C12 = 5,6 pF multilayer ceramic chip capacitor\*
- L1 = 34,6 Ω stripline (17 mm × 4 mm)
- L2 = L5 = 25,3 Ω stripline (6 mm × 6 mm)
- L3 = 45 nH; 4 turns, closely wound enamelled Cu-wire (0,5 mm); int. dia. 2,5 mm; leads 2 × 5 mm
- L4 = L8 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)
- L6 = 29,2 Ω stripline (25,5 mm × 5 mm)
- L7 = 10 nH; 1 turn Cu-wire (1,0 mm); int. dia. 5 mm; leads 2 × 5 mm
- R1 = 1 Ω ± 5% (0,4 W) metal film resistor
- R2 = 10 Ω ± 5% (1,0 W) metal film resistor

\* American Technical Ceramics capacitor type B or capacitor of the same quality.

\*\* Idem type A.

Striplines are on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $E_r = 2,2$ ); thickness 1/32 inch.

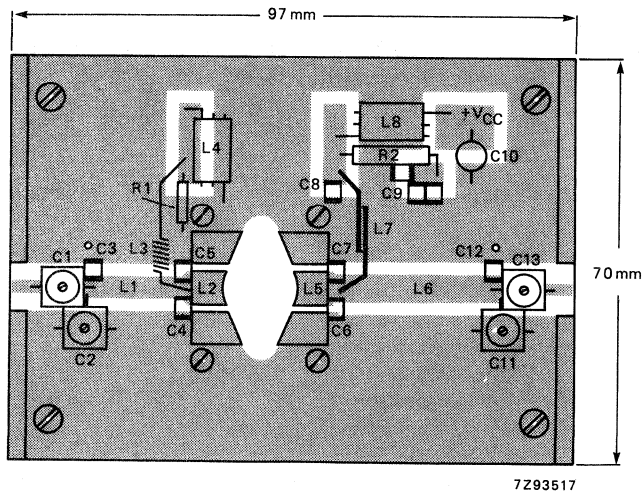
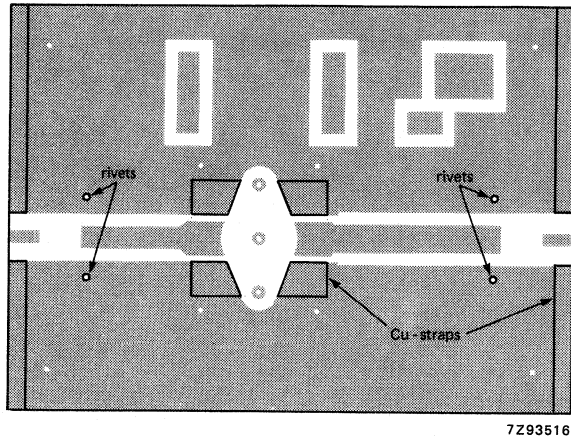


Fig. 6 Printed circuit board and component layout for 470 MHz class-B test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board; the other side is unetched copper serving as a ground plane. Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the bases to provide a direct contact between the copper on the component side and the ground plane.

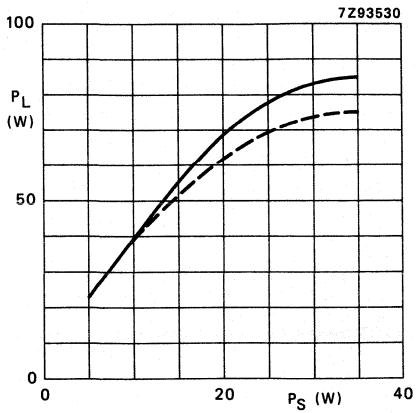


Fig. 7 Load power versus source power.

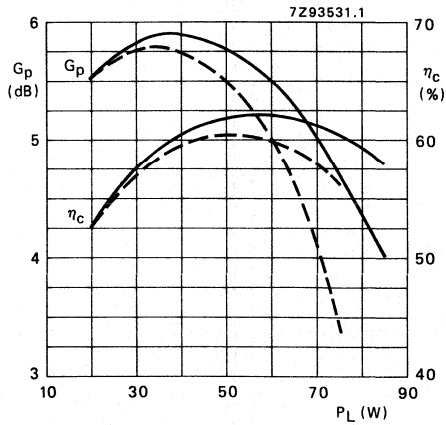


Fig. 8 Power gain and efficiency versus load power.

Conditions for Figs 7 and 8:

Typical values;  $V_{CE} = 12,5 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$  (—) and  $70 \text{ }^\circ\text{C}$  (- - -);  
 $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ ; class-B operation.

**RUGGEDNESS**

The BLU60/12 is capable of withstanding a full load mismatch (VSWR = 50 through all phases) up to 70 W under the following conditions;  $V_{CE} = 15,5 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

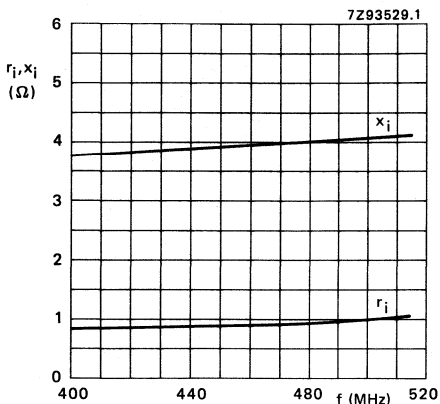


Fig. 9 Input impedance (series components).

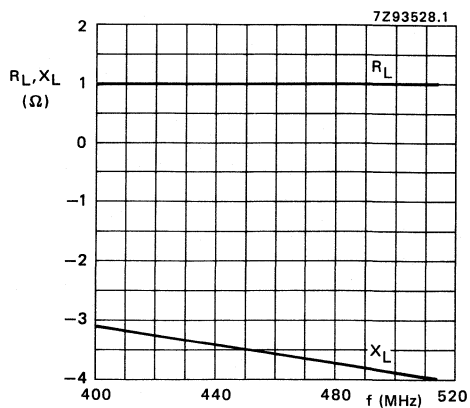


Fig. 10 Load impedance (series components).

Conditions for Figs 9, 10 and 11 (class-B operation):

Typical values;  $V_{CE} = 12,5$  V;  $P_L = 60$  W;  $f = 400$  to  $512$  MHz;  $T_h = 25$  °C;  $R_{th\ mb-h} = 0,2$  K/W.

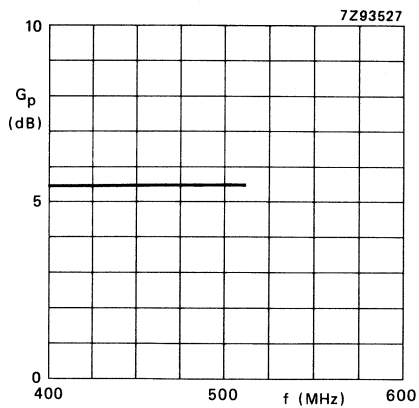


Fig. 11 Power gain versus frequency.



## UHF POWER TRANSISTOR

NPN silicon planar epitaxial transistor primarily intended for use in radio transmitters in the 470 MHz communications band.

### Features

- Multi-base structure and emitter ballasting resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability
- Internal matching to achieve an optimum wideband capability and high power gain

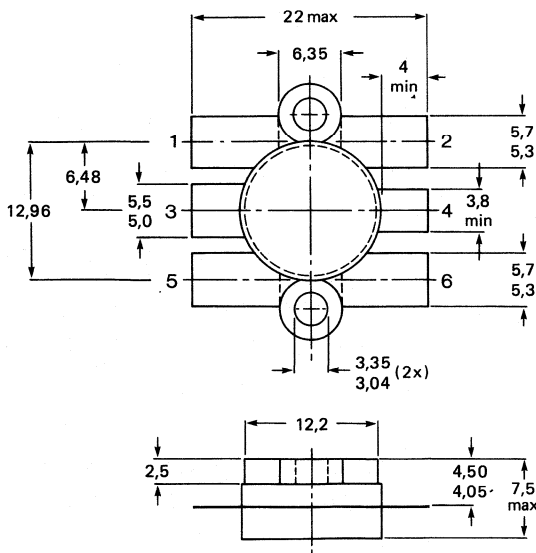
The BLU60/28 has a 6-lead flange envelope with a ceramic cap (SOT119). All leads are isolated from the flange.

### QUICK REFERENCE DATA

RF performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

Mode of operation	f MHz	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
CW class-B	470	28	60	> 7	> 55
CW class-B	470	24	50	typ. 7	typ. 60

### MECHANICAL DATA



### Lead reference

- 1 = emitter
- 2 = emitter
- 3 = base
- 4 = collector
- 5 = emitter
- 6 = emitter

7277385.7

Torque on screw: min. 0.6 Nm (6 kg cm)  
 max. 0.75 Nm (7.5 kg cm)  
 Recommended screw: cheese-head 4-40 UNC/2A  
 Heatsink compound must be applied sparingly, and evenly distributed.

Fig.1 SOT119.

**PRODUCT SAFETY:** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the internal BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage  
(peak value),  $V_{BE} = 0$   
open base

$V_{CESM}$	max.	60 V
$V_{CEO}$	max.	32 V

Emitter-base voltage  
(open collector)

$V_{EBO}$	max.	3.5 V
-----------	------	-------

Collector current  
DC or average  
peak value;  $f > 1$  MHz

$I_C, I_C(AV)$	max.	8.0 A
$I_{CM}$	max.	24 A

RF power dissipation  
 $f > 1$  MHz;  $T_{mb} = 25$  °C

$P_{rf}$	max.	110 W
----------	------	-------

Storage temperature range

$T_{stg}$	-65 to + 150 °C	
-----------	-----------------	--

Operating junction temperature

$T_j$	max.	200 °C
-------	------	--------

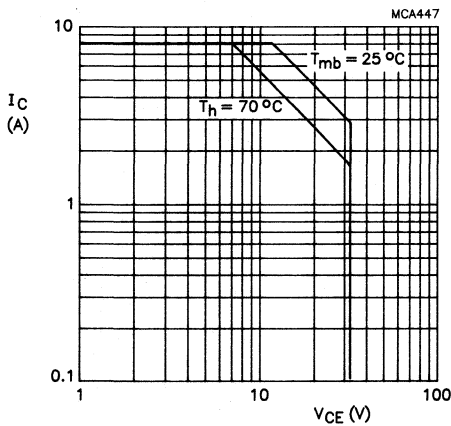
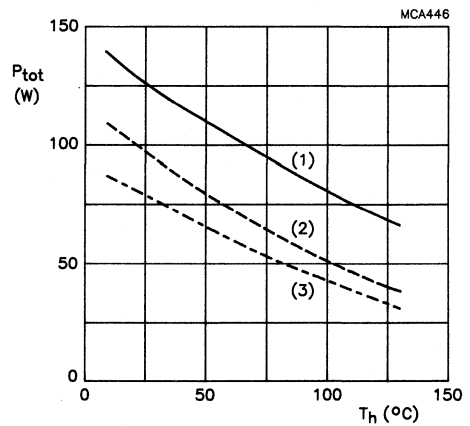


Fig.2 DC SOAR.



- (1) Short-time operation during mismatch.
- (2) Continuous RF operation ( $F > 1$  MHz).
- (3) Continuous DC operation.

Fig.3 Power/temperature derating curves.

**THERMAL RESISTANCE**

RF dissipation = 110 W;  $T_{mb} = 25$  °C

From junction to mounting base

$R_{th j-mb}$	max.	1.55 K/W
---------------	------	----------

From mounting base to heatsink

$R_{th mb-h}$	max.	0.2 K/W
---------------	------	---------

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 30\text{ mA}$   
open base;  $I_C = 200\text{ mA}$

$V_{(BR)CES}$  min. 60 V  
 $V_{(BR)CEO}$  min. 32 V

Emitter-base breakdown voltage

open collector;  $I_E = 20\text{ mA}$

$V_{(BR)EBO}$  min. 3.5 V

Collector cut-off current

$V_{BE} = 0; V_{CE} = 32\text{ V}$

$I_{CES}$  max. 10 mA

DC current gain

$I_C = 3.2\text{ A}; V_{CE} = 25\text{ V}$

$h_{FE}$  20 to 120  
typ. 75

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 28\text{ V}$

$C_c$  typ. 90 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 0; V_{CE} = 28\text{ V}$

$C_{re}$  typ. 55 pF

Collector-flange capacitance

$C_{cf}$  typ. 3.0 pF

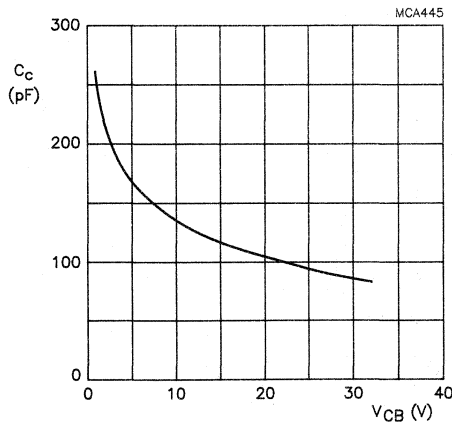
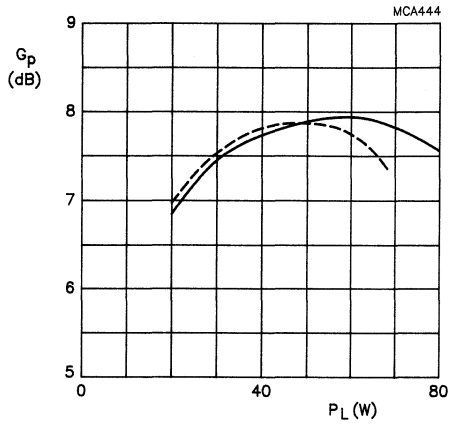


Fig.4 Collector capacitance as a function of base-collector voltage;  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

**APPLICATION INFORMATION**

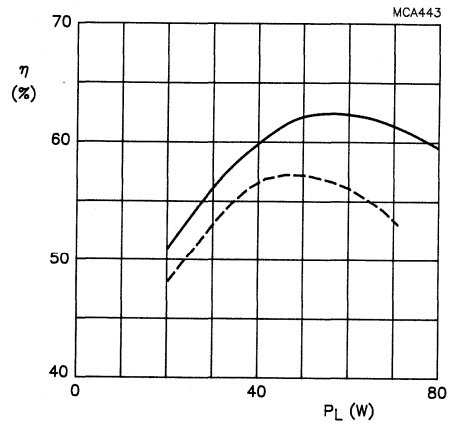
RF performance at  $T_h = 25\text{ }^\circ\text{C}$  in a class-B test circuit

Mode of operation	f MHz	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
CW class-B	470	28	60	> 7	> 55
CW class-B	470	24	50	typ. 7	typ. 60



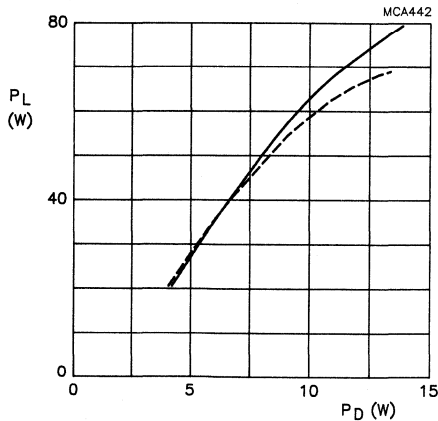
—  $T_h = 25\text{ }^\circ\text{C}$   
 - - -  $T_h = 70\text{ }^\circ\text{C}$

Fig.5 Power gain as a function of load power; typical values.



—  $T_h = 25\text{ }^\circ\text{C}$   
 - - -  $T_h = 70\text{ }^\circ\text{C}$

Fig.6 Efficiency as a function of load power; typical values.



—  $T_h = 25\text{ }^\circ\text{C}$   
 - - -  $T_h = 70\text{ }^\circ\text{C}$

Fig.7 Load power as a function of drive power; typical values.

**Conditions for Figs 5 to 7**

Class-B operation;  $V_{CE} = 28\text{ V}$ ;  $f = 470\text{ MHz}$ ;  $R_{th\text{ mb-h}} = 0.2\text{ K/W}$ .

**Ruggedness in class-B operation**

The BLU60/28 is capable of withstanding a load mismatch corresponding with  $V_{SWR} = 50$  through all phases under the following conditions:  $V_{CE} = 28 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0.2 \text{ K/W}$ , at rated output power.

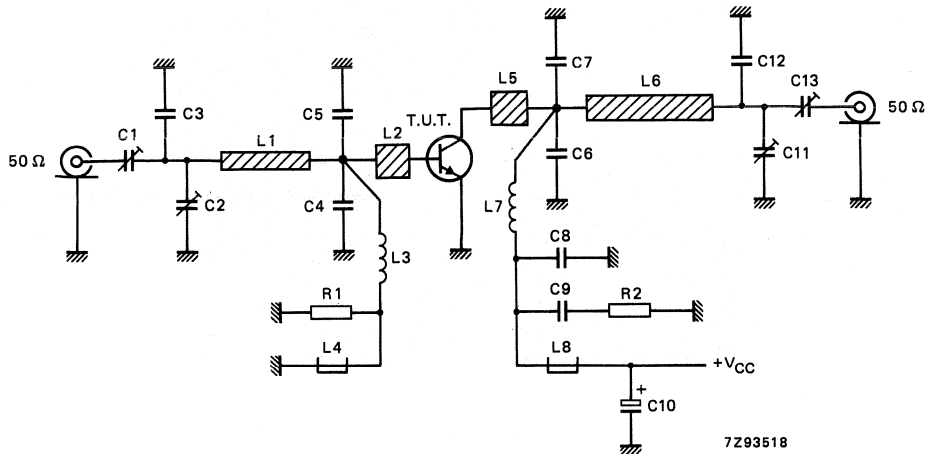


Fig.8 Class-B test circuit at  $f = 470 \text{ MHz}$ .

**List of components**

- C1 = C13 = 1.8 to 10 pF film dielectric trimmer (cat. no. 2222 809 05002)
- C2 = C11 = 1.4 to 5.5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C3 = 12 pF multilayer ceramic chip capacitor\*
- C4 = C5 = 8.2 pF multilayer ceramic chip capacitor\*\*
- C6 = C7 = 15 pF multilayer ceramic chip capacitor\*
- C8 = 110 pF multilayer ceramic chip capacitor\*
- C9 = 3 x 100 nF multilayer ceramic chip capacitors in parallel
- C10 = 2.2  $\mu\text{F}$  (35 V) electrolytic capacitor
- C12 = 5.6 pF multilayer ceramic chip capacitor\*
- L1 = 34.6  $\Omega$  stripline (17 mm x 4 mm)
- L2 = L5 = 25.3  $\Omega$  stripline (6 mm x 6 mm)
- L3 = 45 nH; 4 turns, closely wound enamelled Cu-wire (0.5 mm); int. diam. 2.5 mm; leads 2 x 5 mm
- L4 = L8 = Ferroxcube wideband HF choke, grade 3B (cat. no. 4312 020 36642)
- L6 = 29.2  $\Omega$  stripline (25.5 mm x 5 mm)
- L7 = 10 nH; 1 turn Cu-wire (1.0 mm); int. diam. 5 mm; leads 2 x 5 mm
- R1 = 1  $\Omega \pm 5\%$  (0.4 W) metal film resistor
- R2 = 10  $\Omega \pm 5\%$  (1.0 W) metal film resistor

Striplines are on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric; thickness 1/32 inch; ( $\epsilon_r = 2.2$ ).

\* American Technical Ceramics capacitor type B or equivalent.

\*\* Idem type A.

APPLICATION INFORMATION (continued)

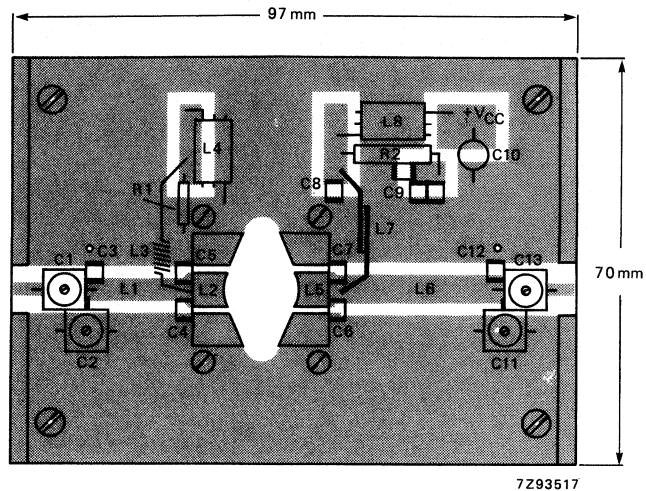


Fig.9 Component layout of 470 MHz, class-B test circuit.

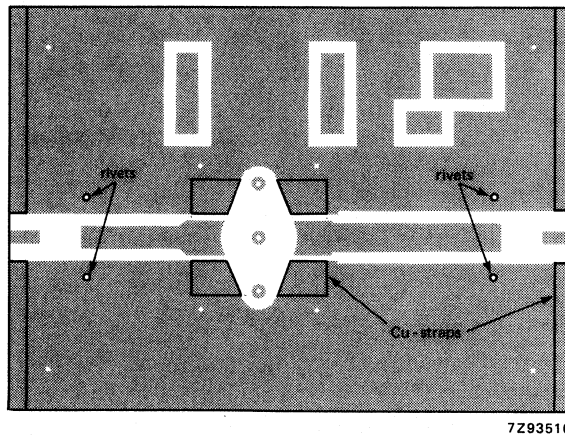


Fig.10 Printed-circuit board for 470 MHz, class-B test circuit.

**NOTE**

The circuit and the components are on one side of the PTFE fibre-glass board; the other side is fully metallized serving as groundplane. Earth connections are made by fixing screws, hollow rivets and also by copper straps under the emitter to provide a direct contact between the copper on the component side and the ground plane.

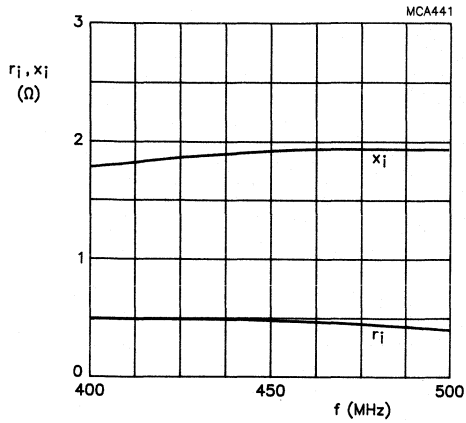


Fig.11 Input impedance as a function of frequency (series components); typical values.

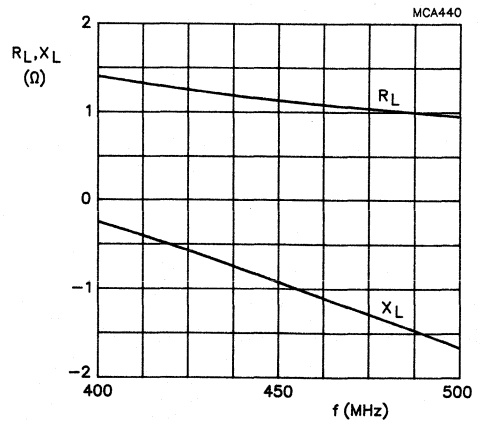


Fig.12 Load impedance as a function of frequency (series components); typical values.

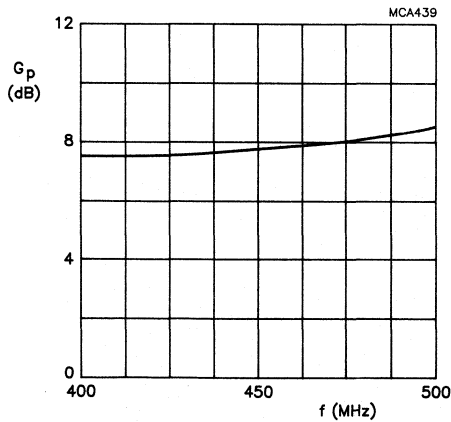


Fig.13 Gain as a function of frequency; typical values.

**Conditions for Figs 11 to 13**

Class-B operation;  $V_{CE} = 28$  V;  $P_L = 60$  W;  $R_{th\ mb-h} = 0.2$  K/W.





## Philips Components

Data sheet	
status	Preliminary specification
date of issue	October 1990

# BLU86

## UHF power transistor

### DESCRIPTION

NPN silicon planar epitaxial transistor, designed for use in mobile radio transmitters in the 900 MHz communications band. The transistor is encapsulated in a surface-mounted envelope (SOT223).

### QUICK REFERENCE DATA

RF performance at  $T_{\text{coll.tab}} = 135 \text{ }^{\circ}\text{C}$  in a common emitter class-B test circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
c.w. narrow band	900	12.5	1.0	> 7	> 55

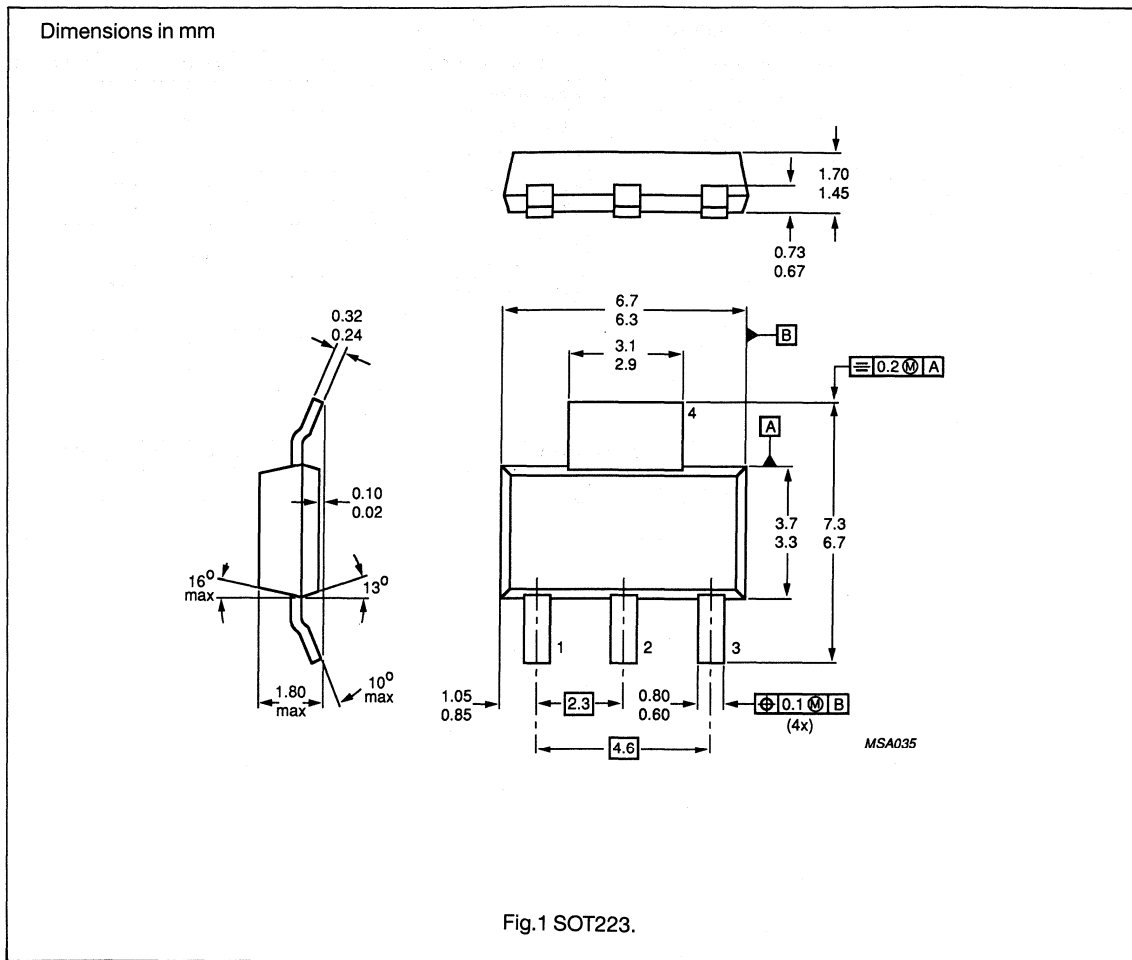
### MECHANICAL DATA

SOT223 - see Fig.1.

# UHF power transistor

# BLU86

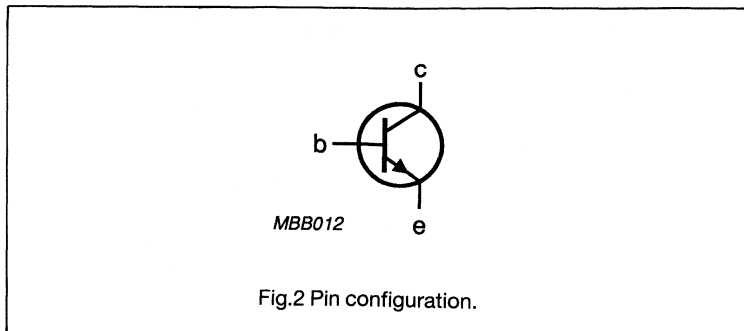
## MECHANICAL DATA



### PINNING

PIN	DESCRIPTION
1	emitter
2	base
3	emitter
4	collector

### PIN CONFIGURATION



## UHF power transistor

BLU86

## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	-	30	V
$V_{CEO}$	collector-emitter voltage	open base	-	15	V
$V_{EBO}$	emitter-base voltage	open collector	-	2	V
$I_c$	collector current	DC or average value	-	150	mA
$I_{CM}$	collector current	peak value $f > 1$ MHz	-	450	mA
$P_{tot}$	total power dissipation	$T_{coll.tab} = 135$ °C $f > 1$ MHz	-	2	W
$T_{stg}$	storage temperature range		-65	150	°C
$T_j$	operating junction temperature		-	175	°C

## THERMAL RESISTANCE

SYMBOL	PARAMETER	MAX.	UNIT
$R_{th\ j-tab(DC)}$	from junction to collector-tab	20	K/W

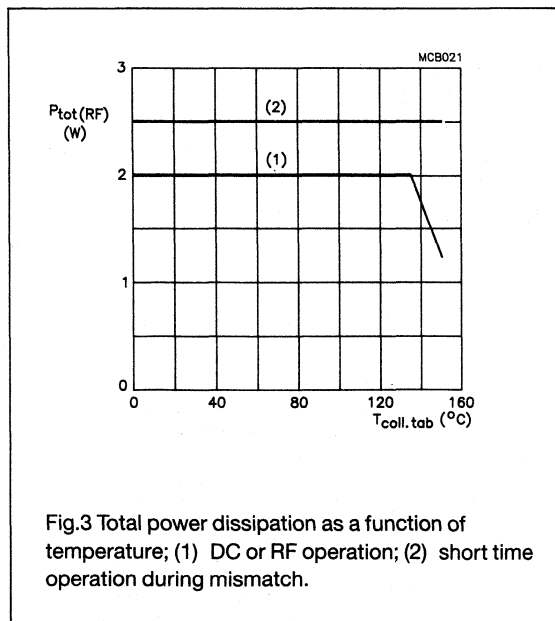


Fig.3 Total power dissipation as a function of temperature; (1) DC or RF operation; (2) short time operation during mismatch.

# UHF power transistor

# BLU86

## CHARACTERISTICS

at  $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter $I_C = 2.5\text{ mA}$	30	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base $I_C = 5\text{ mA}$	15	-	-	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector $I_E = 0.5\text{ mA}$	2	-	-	V
$I_{CES}$	collector-emitter cut-off current	$V_{BE} = 0$ $V_{CE} = 15\text{ V}$	-	-	1	mA
$h_{FE}$	DC current gain	$V_{CE} = 10\text{ V}$ $I_C = 100\text{ mA}$	80	-	-	
$C_c$	collector capacitance	$V_{CB} = 12.5\text{ V}$ $I_E = I_e = 0$ $f = 1\text{ MHz}$	-	2	3.5	pF
$C_{re}$	feedback capacitance	$V_{CE} = 12.5\text{ V}$ $I_C = 0$ $f = 1\text{ MHz}$	-	1.2	2.5	pF

## APPLICATION INFORMATION

RF performance at  $T_{coll.tab} = 135\text{ }^\circ\text{C}$  in a common emitter class-B test circuit.

MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$G_p$ (dB)	$\eta_c$ (%)
c.w. narrow band	900	12.5	1.0	> 7 typ. 9	> 55 typ. 65

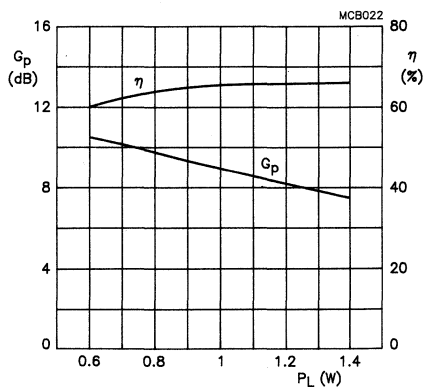


Fig.4 Power gain and efficiency as functions of load power; typical values.

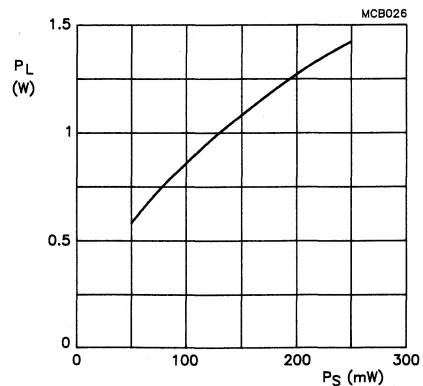


Fig.5 Load power as a function of input power; typical values.

# UHF power transistor

# BLU86

## Ruggedness in class-B operation

The BLU86 is capable of withstanding a load mismatch corresponding to  $V_{SWR} = 50$  through all phases, at rated output power up to a supply voltage of 15.5 V,  $f = 900$  MHz and  $T_{coll.tab} = 135$  °C.

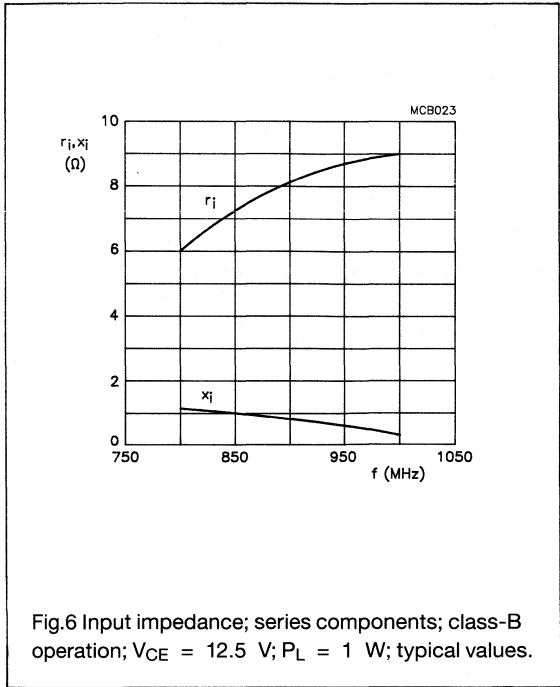


Fig.6 Input impedance; series components; class-B operation;  $V_{CE} = 12.5$  V;  $P_L = 1$  W; typical values.

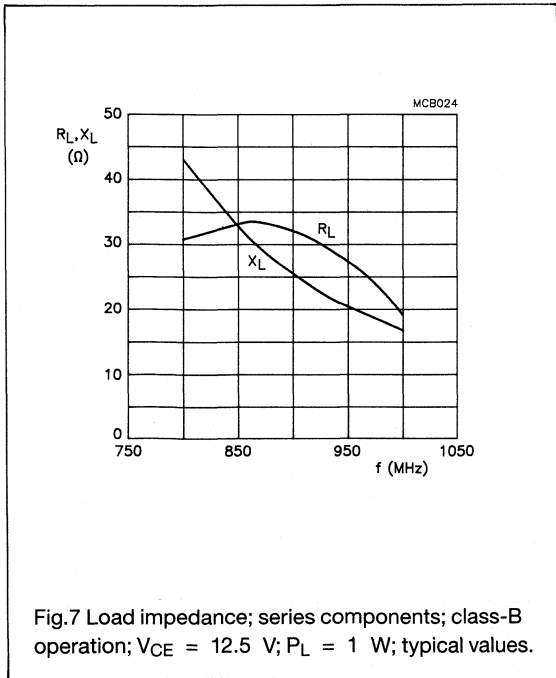


Fig.7 Load impedance; series components; class-B operation;  $V_{CE} = 12.5$  V;  $P_L = 1$  W; typical values.

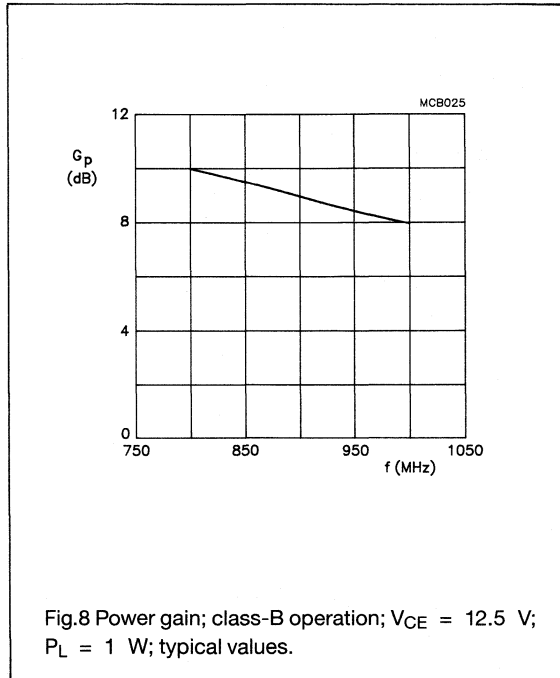


Fig.8 Power gain; class-B operation;  $V_{CE} = 12.5$  V;  $P_L = 1$  W; typical values.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor designed for use in mobile radio transmitters in the 470 MHz band.

**Features:**

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile.
- gold metallization ensures excellent reliability.

The transistor has a 4-lead stud envelope with a ceramic cap (SOT-122). All leads are isolated from the stud.

**QUICK REFERENCE DATA**

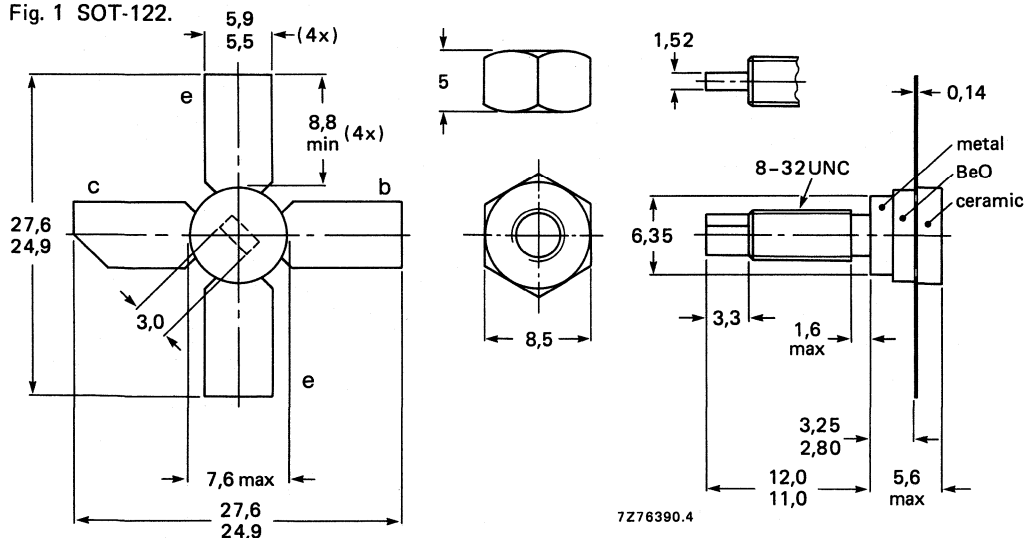
R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	470	7	> 8,5	> 55

**MECHANICAL DATA**

Dimensions in mm

Fig. 1 SOT-122.



Torque on put: min. 0,75 Nm (7,5 kg.cm)  
max. 0,85 Nm (8,5 kg.cm)

When locking is required an adhesive is preferred instead of a lock washer.

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
Deburring must leave surface flat; do not chamfer or countersink either end of hole.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current	$I_C$	max.	1,2 A
d.c. or average	$I_{CM}$	max.	3,6 A
(peak value); $f > 1$ MHz			
Total power dissipation	$P_{tot(d.c.)}$	max.	17 W
at $T_{mb} = 52$ °C	$P_{tot(r.f.)}$	max.	22,5 W
$f > 1$ MHz; $T_{mb} = 52$ °C			
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

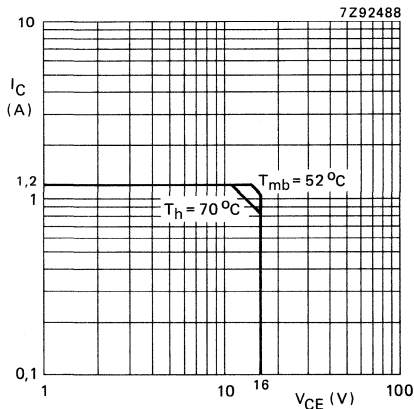


Fig. 2 D.C. SOAR.  
 $R_{th\ mb-h} = 0,6$  K/W.

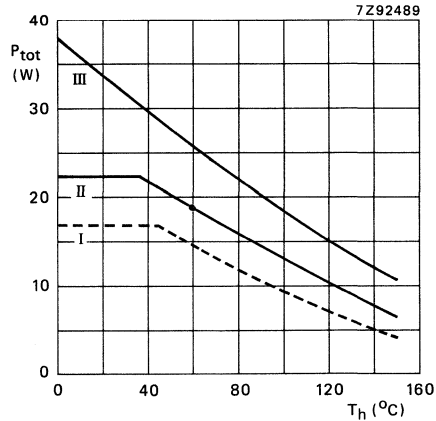


Fig. 3 Power/temperature derating curves.  
 I Continuous operation  
 II Continuous operation ( $f > 1$  MHz)  
 III Short-time operation during mismatch;  
 ( $f > 1$  MHz).

**THERMAL RESISTANCE**

Dissipation = 15 W;  $T_{mb} = 25$  °C

From junction to mounting base  
 (d.c. dissipation)

(r.f. dissipation)

From mounting base to heatsink

$R_{th\ j-mb(dc)}$	=	7,5 K/W
$R_{th\ j-mb(rf)}$	=	5,6 K/W
$R_{th\ mb-h}$	=	0,6 K/W



**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage, open emitter;  $I_C = 15\text{ mA}$

Collector-emitter breakdown voltage, open base;  $I_C = 30\text{ mA}$

Emitter-base breakdown voltage, open collector;  $I_E = 1,5\text{ mA}$

Collector cut-off current,  $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

Second breakdown energy,  $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

D.C. current gain,  $I_C = 0,9\text{ A}$ ;  $V_{CE} = 10\text{ V}$

Transition frequency at  $f = 500\text{ MHz}^*$ ,  $-I_E = 0,9\text{ A}$ ;  $V_{CB} = 12,5\text{ V}$

Collector capacitance at  $f = 1\text{ MHz}$ ,  $I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

Feed-back capacitance at  $f = 1\text{ MHz}$ ,  $I_C = 0$ ;  $V_{CE} = 12,5\text{ V}$

Collector-stud capacitance

$V_{(BR)CBO}$	>	36 V
$V_{(BR)CEO}$	>	16 V
$V_{(BR)EBO}$	>	3 V
$I_{CES}$	<	7,5 mA
$E_{SBR}$	>	2,3 mJ
$h_{FE}$	>	25
		typ. 100
$f_T$		typ. 4,0 GHz
$C_c$		typ. 10 pF
$C_{re}$		typ. 7 pF
$C_{cs}$		typ. 1,2 pF

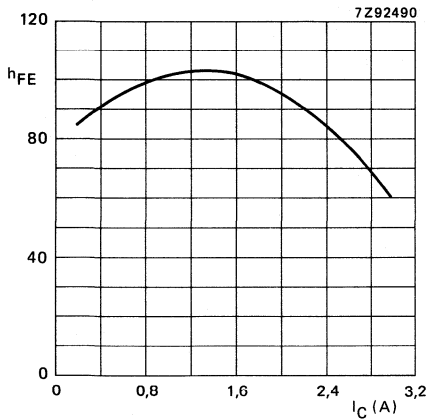


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ ;  $V_{CE} = 10\text{ V}$ ; typical values.

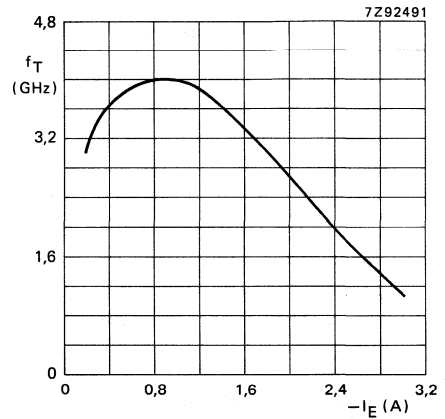


Fig. 5  $V_{CB} = 12,5\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $t_p = 50\text{ }\mu\text{s}$ ;  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

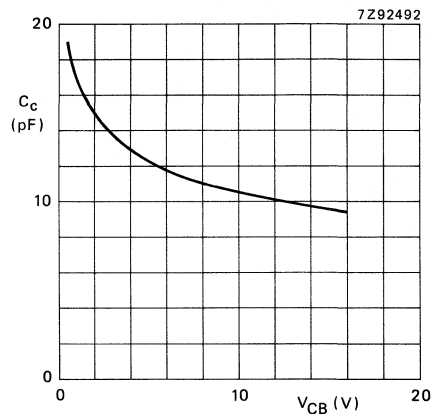


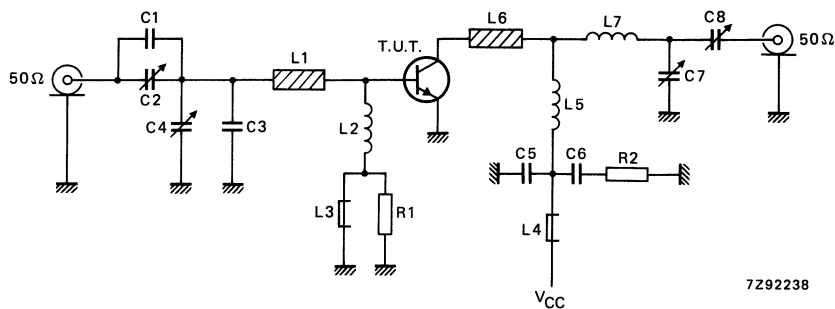
Fig. 6  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

\* Measured under pulse conditions:  $t_p = 50\text{ }\mu\text{s}$ ;  $\delta < 1\%$ .

## APPLICATION INFORMATION

R.F. performance in common-emitter circuit; class-B:  $f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ 

mode of operation	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta_C$ %
narrow band; c.w.	12,5	7	< 0,99 typ. 0,55	> 8,5 typ. 11,0	< 1,0 typ. 0,8	> 55 typ. 70

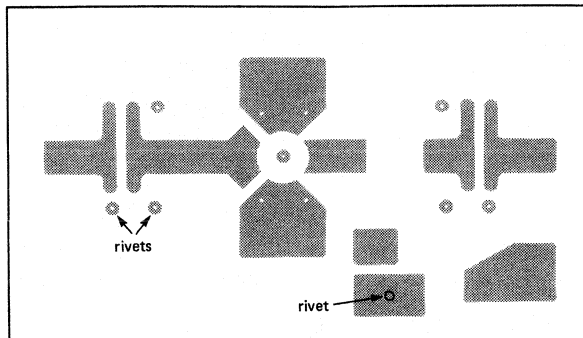
Fig. 7 Class-B test circuit at  $f = 470 \text{ MHz}$ .

## List of components:

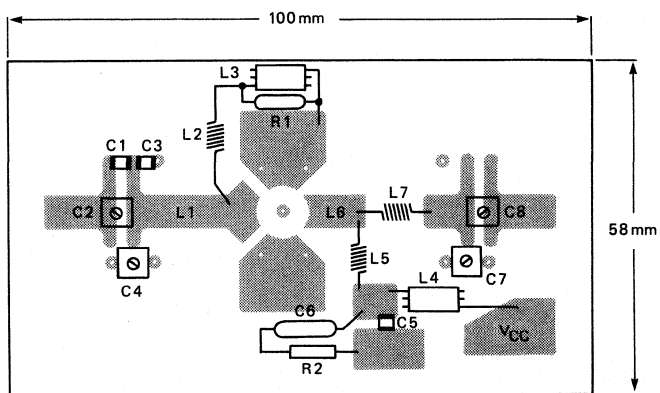
- C1 = 2,7 pF multilayer ceramic chip capacitor\*
- C2 = C7 = C8 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C3 = 7,5 pF multilayer ceramic chip capacitor\*
- C4 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)
- C5 = 100 pF multilayer ceramic chip capacitor
- C6 = 100 nF metallized film capacitor
- L1 = 38  $\Omega$  stripline (22,5 mm x 6,0 mm)
- L2 = 15 nH; 1 turn Cu wire (1,0 mm); int. dia. 5 mm; leads 2 x 5 mm
- L3 = L4 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)
- L5 = 29 nH; 2 turns enamelled Cu wire (1,0 mm); int. dia. 6 mm; length 3,5 mm; leads 2 x 5 mm
- L6 = 38  $\Omega$  stripline (10,0 mm x 6,0 mm)
- L7 = 7 nH; 1/2 turn Cu wire (1,0 mm); int. dia. 5,0 mm; leads 2 x 5 mm
- R1 = R2 = 10  $\Omega \pm 10\%$ ; 0,25 W metal film resistor

L1 and L6 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16 inch.

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.



7Z90362



7Z90361

Fig. 8 Printed circuit board and component lay-out for 470 MHz class-B test circuit.

**Note**

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as ground plane. Earth connections are made by hollow rivets and also by copper straps under the emitters.

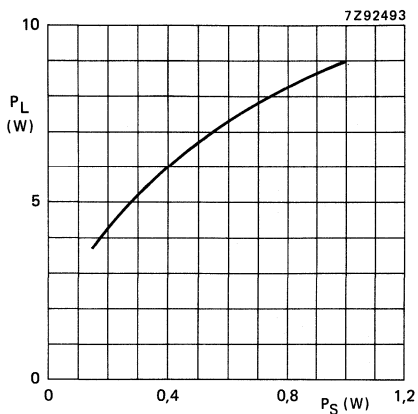


Fig. 9 Load power vs. source power.

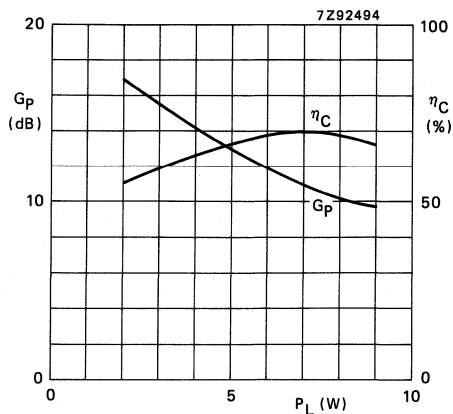


Fig. 10 Power gain and efficiency vs. load power.

Conditions for Figs 9 and 10:

$V_{CE} = 12,5$  V;  $f = 470$  MHz;  $T_h = 25$  °C; class-B operation; typical values.

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 15,5 V and  $T_h = 25$  °C.

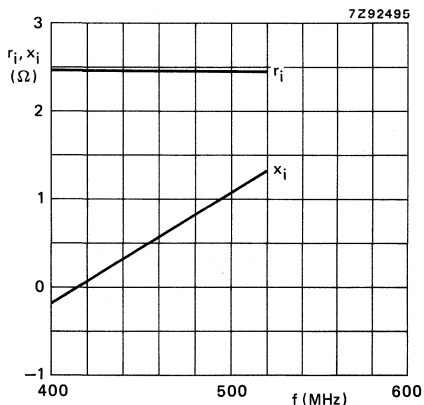


Fig. 11 Input impedance (series components).

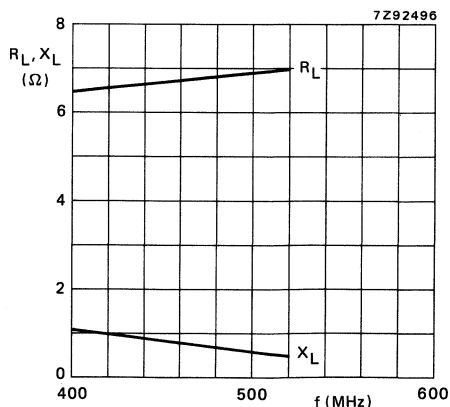


Fig. 12 Load impedance (series components).

Conditions for Figs 11 and 12:

$V_{CE} = 12,5$  V;  $P_L = 7$  W;  $f = 400-520$  MHz;  $T_h = 25$  °C; class-B operation; typical values.

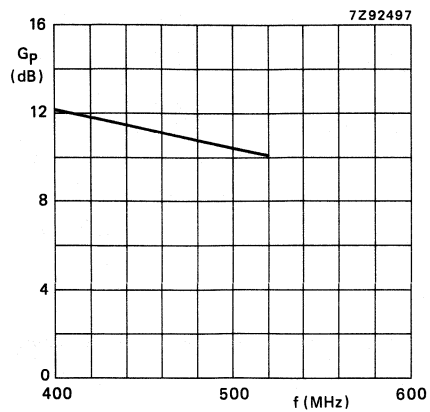


Fig. 13 Power gain vs. frequency.

$V_{CE} = 12,5$  V;  $P_L = 7$  W;  $f = 400$ -520 MHz;  $T_h = 25$  °C;  
class-B operation; typical values.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor designed for use in mobile radio transmitters in the 900 MHz band.

**Features:**

- emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability.

The transistor is encapsulated in a subminiature plastic transfer-moulded cross package (SOT-103).

**QUICK REFERENCE DATA**

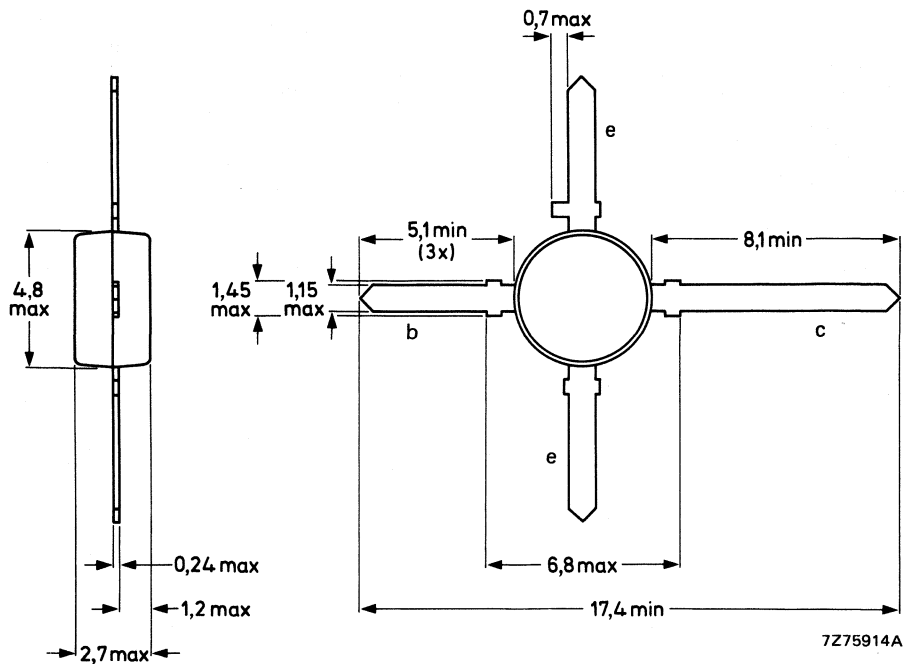
R.F. performance at  $T_{amb} = 25\text{ }^{\circ}\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	900	0,5	> 8,0	> 50

**MECHANICAL DATA**

Dimensions in mm

Fig. 1 SOT-103.



**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
d.c. or average	$I_C$	max.	150 mA
(peak value); $f > 1$ MHz	$I_{CM}$	max.	500 mA
Total power dissipation at $T_{coll. tap} = 75$ °C	$P_{tot}$	max.	1,65 W
Total power dissipation* at $T_{amb} = 25$ °C	$P_{tot}$	max.	1,0 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	175 °C

**THERMAL RESISTANCE\***

From junction to collector tap (d.c.)	$R_{th j-ct(dc)}$	=	60 K/W
From junction to ambient (d.c.)	$R_{th j-a(dc)}$	=	150 K/W

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector-base breakdown voltage open emitter; $I_C = 2,5$ mA	$V_{(BR)CBO}$	>	36 V
Collector-emitter breakdown voltage open base; $I_C = 10$ mA	$V_{(BR)CEO}$	>	16 V
Emitter-base breakdown voltage open collector; $I_E = 0,5$ mA	$V_{(BR)EBO}$	>	3 V
Collector cut-off current $V_{BE} = 0$ ; $V_{CE} = 16$ V	$I_{CES}$	<	1 mA
D.C. current gain $I_C = 100$ mA; $V_{CE} = 10$ V	$h_{FE}$	>	25
Transition frequency at $f = 500$ MHz** $-I_E = 100$ mA; $V_{CB} = 12,5$ V	$f_T$	typ.	4,0 GHz
Collector capacitance at $f = 1$ MHz $I_E = i_e = 0$ ; $V_{CB} = 12,5$ V	$C_c$	typ.	2,1 pF
Feed-back capacitance at $f = 1$ MHz $I_C = 0$ ; $V_{CE} = 12,5$ V	$C_{re}$	typ.	1,3 pF

\* Transistor mounted on a p.c. board with a collector area of 50 mm<sup>2</sup>.

\*\* Measured under pulse conditions:  $t_p = 50$   $\mu$ s;  $\delta < 1\%$ .



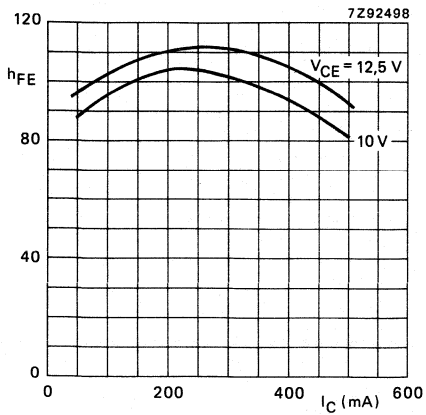


Fig. 2  $T_j = 25$  °C; typical values.

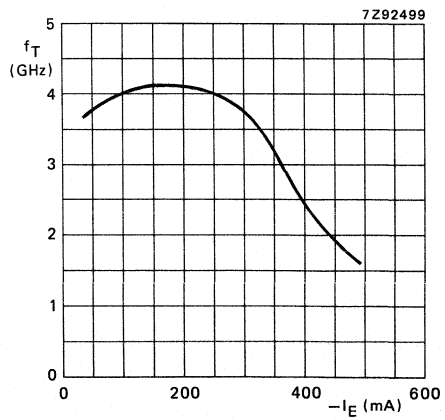


Fig. 3  $V_{CB} = 12.5$  V;  $f = 500$  MHz;  
 $T_j = 25$  °C; typical values.

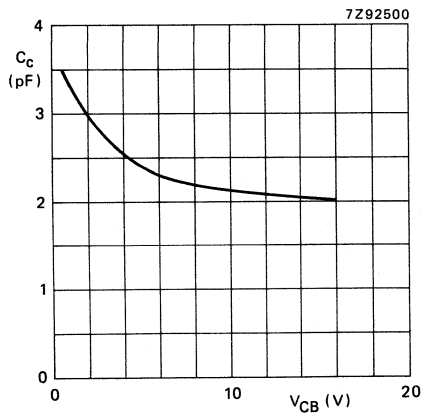


Fig. 4  $I_E = i_e = 0$ ;  $f = 1$  MHz; typical values.

APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class-B):  $f = 900 \text{ MHz}$ ;  $T_{\text{amb}} = 25 \text{ }^\circ\text{C}$

mode of operation	$V_{\text{CE}}$ V	$P_{\text{L}}$ W	$P_{\text{S}}$ W	$G_{\text{p}}$ dB	$I_{\text{C}}$ mA	$\eta_{\text{C}}$ %
narrow band; c.w.	12,5	0,5	< 0,079 typ. 0,056	> 8,0 typ. 9,5	< 80 typ. 62	> 50 typ. 65

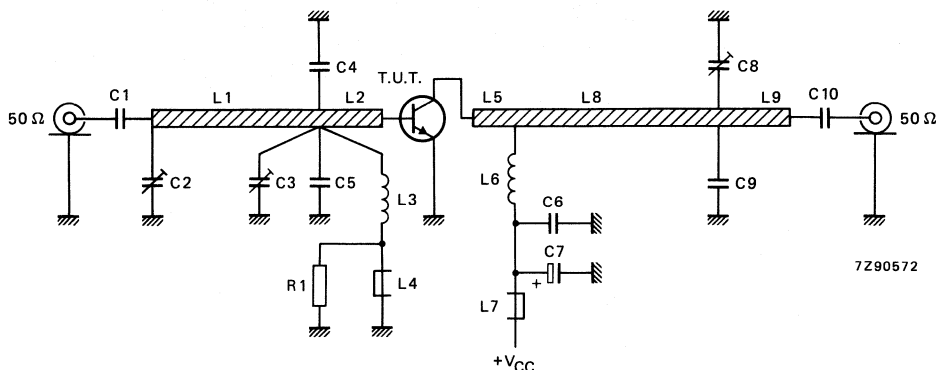


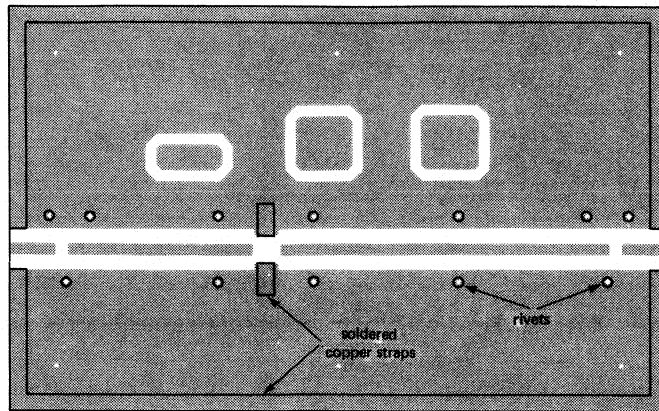
Fig. 5 Class-B test circuit at  $f = 900 \text{ MHz}$ .

List of components:

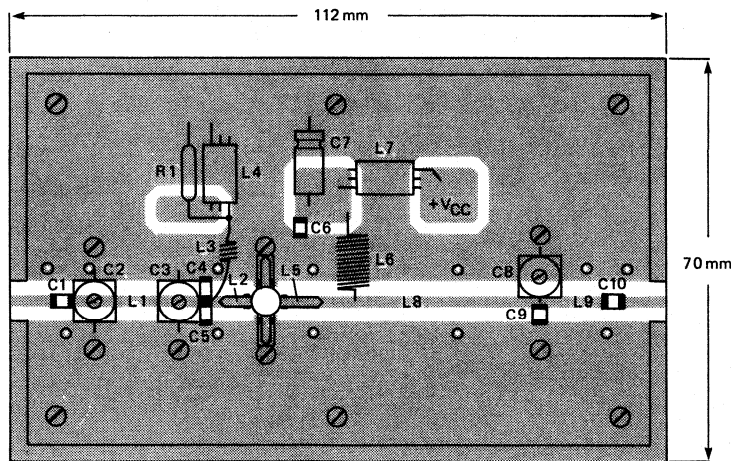
- C1 = C6 = C10 = 330 pF multilayer ceramic chip capacitor
- C2 = C3 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C4 = C5 = 6,8 pF multilayer ceramic chip capacitor\*
- C7 = 6,8  $\mu\text{F}$  (63 V) electrolytic capacitor
- C8 = 1,0 to 3,5 pF film dielectric trimmer (cat. no. 2222 809 05001)
- C9 = 1,2 pF multilayer ceramic chip capacitor\*
- L1 = 50  $\Omega$  stripline (24,0 mm x 2,4 mm)
- L2 = 50  $\Omega$  stripline (8,0 mm x 2,4 mm)
- L3 = 60 nH; 4 turns closely wound enamelled Cu wire (0,4 mm); int. dia. 3 mm; leads 2 x 5 mm
- L4 = L7 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)
- L5 = 50  $\Omega$  stripline (14,0 mm x 2,4 mm)
- L6 = 245 nH; 9 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 5 mm; leads 2 x 3 mm
- L8 = 50  $\Omega$  stripline (32,5 mm x 2,4 mm)
- L9 = 50  $\Omega$  stripline (10,0 mm x 2,4 mm)
- R1 = 10  $\Omega \pm 10\%$ ; 0,25 W metal film resistor

L1, L2, L5, L8 and L9 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch.

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.



7Z90573



7Z90574

Fig. 6 Printed circuit board and component lay-out for 900 MHz class-B test circuit.

**Note**

The circuit and the components are on one side of P.T.F.E. fibre-glass board; the other side is unetched copper serving as ground plane. Earth connections are made by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the ground plane.

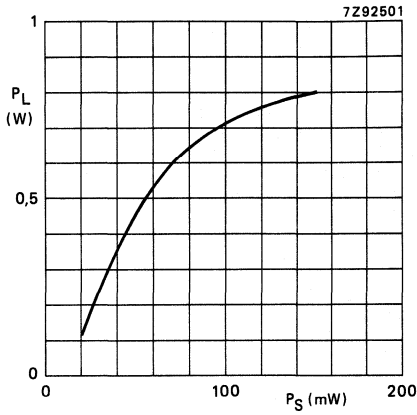


Fig. 7 Load power vs. source power.

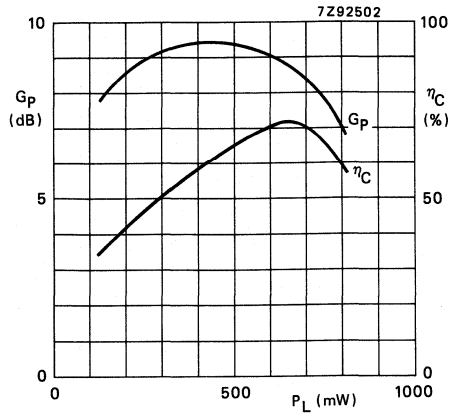


Fig. 8 Power gain and efficiency vs. load power.

Conditions for Figs 7 and 8:

$V_{CE} = 12,5$  V;  $f = 900$  MHz;  $T_{amb} = 25$  °C; class-B operation; test circuit tuned at  $P_L = 0,5$  W; typical values.

**RUGGEDNESS**

The transistor is capable of withstanding a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 15,5 V and  $T_{amb} = 25$  °C.

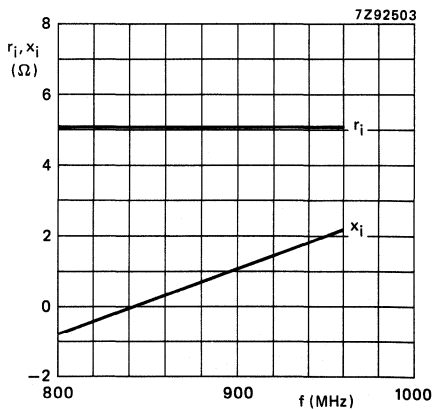


Fig. 9 Input impedance (series components).

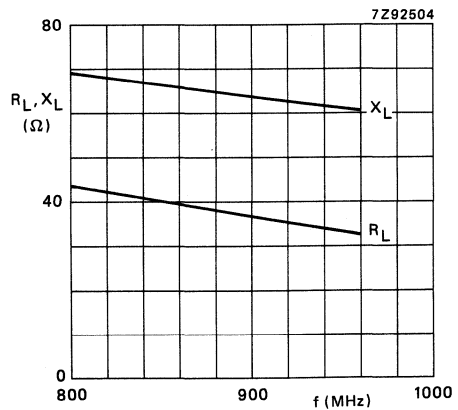


Fig. 10 Load impedance (series components).

Conditions for Figs 9 and 10:

$V_{CE} = 12,5$  V;  $P_L = 0,5$  W;  $f = 800-960$  MHz;  $T_{amb} = 25$  °C; class-B operation; typical values.

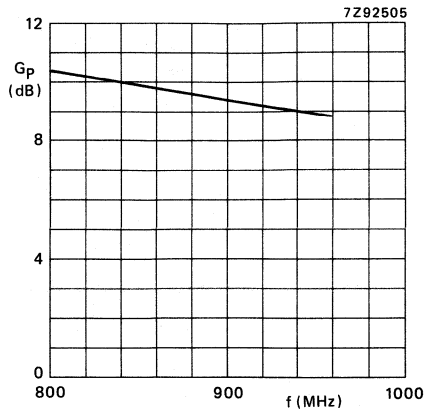


Fig. 11 Power gain vs. frequency.

$V_{CE} = 12,5 \text{ V}$ ;  $P_L = 0,5 \text{ W}$ ;  $f = 800\text{-}960 \text{ MHz}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ ;  
class-B operation; typical values.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in mobile radio transmitters in the u.h.f. band. The transistor is also very suitable for application in the 900 MHz mobile radio band.

**Features:**

- multi-base structure and diffused emitter-ballasting resistors for an optimum temperature profile;
- gold metallization ensures excellent reliability.

The transistor has a 4-lead stud envelope with a ceramic cap (SOT-122). All leads are isolated from the stud.

**QUICK REFERENCE DATA**

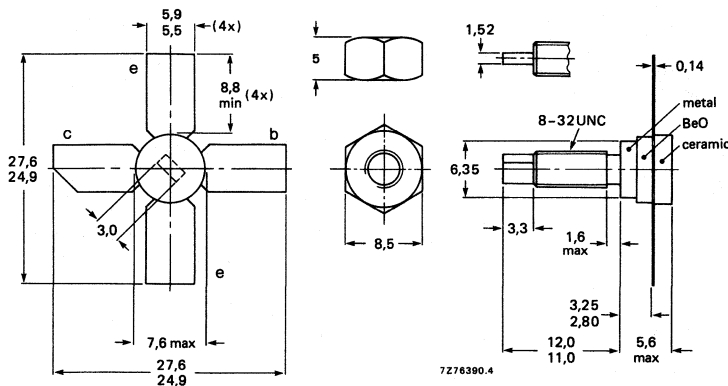
R.F. performance at  $T_h = 25^\circ\text{C}$  in a common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_c$ %
narrow band; c.w.	12,5	470	5	> 10,5	> 60
	12,5	900	4	typ. 7,0	typ. 60

**MECHANICAL DATA**

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm (7,5 kg.cm) max. 0,85 Nm (8,5 kg.cm) Diameter of clearance hole in heatsink: max. 4,2 mm Mounting hole to have no burrs at either end. De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CB0}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
d.c. or average	$I_C; I_{C(AV)}$	max.	0,8 A
peak value; $f > 1$ MHz	$I_{CM}$	max.	2,5 A
D.C. power dissipation up to $T_{mb} = 50$ °C	$P_{tot}$ (d.c.)	max.	12,5 W
R.F. power dissipation			
$f > 1$ MHz; $T_{mb} = 25$ °C	$P_{tot}$ (r.f.)	max.	19 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

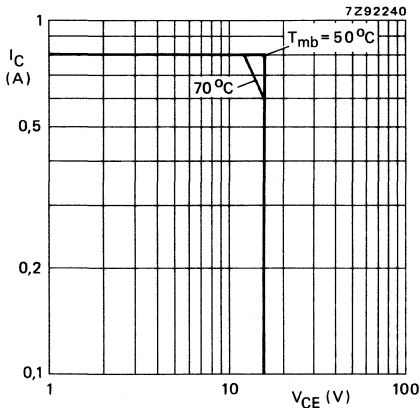


Fig. 2 D.C. SOAR.  
 $R_{th\ mb-h} = 0,6$  K/W.

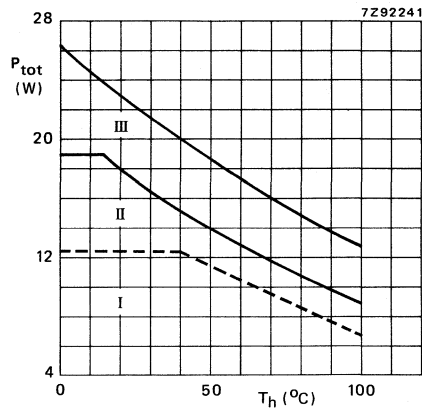


Fig. 3 Power/temperature derating curves.  
 I Continuous d.c. operation.  
 II Continuous r.f. operation ( $f > 1$  MHz).  
 III Short-time r.f. operation during mismatch; ( $f > 1$  MHz).

**THERMAL RESISTANCE** (dissipation = 9 W;  $T_{mb} = 25$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	10 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	7,5 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,6 K/W



## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 10\text{ mA}$

$V_{(BR)CBO} > 36\text{ V}$

Collector-emitter breakdown voltage  
open base;  $I_C = 20\text{ mA}$

$V_{(BR)CEO} > 16\text{ V}$

Emitter-base breakdown voltage  
open collector;  $I_E = 1\text{ mA}$

$V_{(BR)EBO} > 3\text{ V}$

Collector cut-off current  
 $V_{BE} = 0; V_{CE} = 16\text{ V}$

$I_{CES} < 5\text{ mA}$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$   
 $R_{BE} = 10\ \Omega$

$E_{SBR} > 1\text{ mJ}$

D.C. current gain\*\*

$I_C = 0,6\text{ A}; V_{CE} = 10\text{ V}$

$h_{FE} > 25$   
typ. 100

Transition frequency at  $f = 500\text{ MHz}^*$

$I_C = 0,6\text{ A}; V_{CE} = 12,5\text{ V}$

$f_T$  typ. 4,0 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 12,5\text{ V}$

$C_c$  typ. 7,5 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 0; V_{CE} = 12,5\text{ V}$

$C_{re}$  typ. 5 pF

Collector-stud capacitance

$C_{cs}$  typ. 1,2 pF

\* Measured under pulse conditions:  $t_p = 50\ \mu\text{s}; \delta < 0,01$ .

\*\* Measured under pulse conditions:  $t_p = 300\ \mu\text{s}; \delta < 0,01$ .

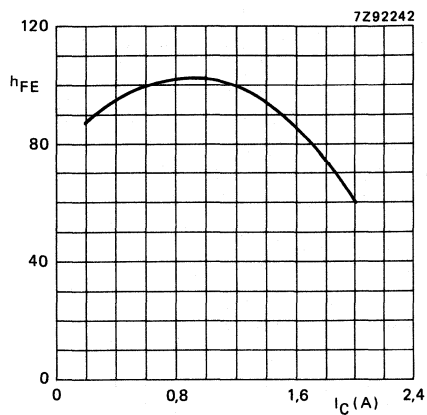


Fig. 4  $V_{CE} = 10$  V;  $T_j = 25$  °C; typ. values.

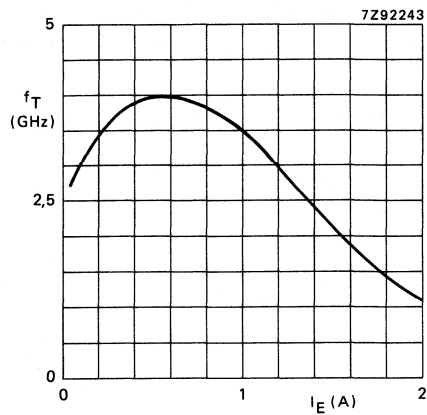


Fig. 5  $V_{CB} = 12,5$  V;  $f = 500$  MHz;  $T_j = 25$  °C; typ. values.

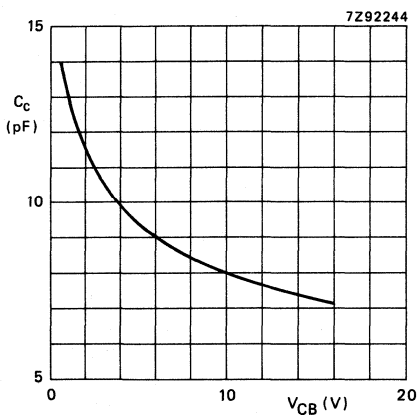
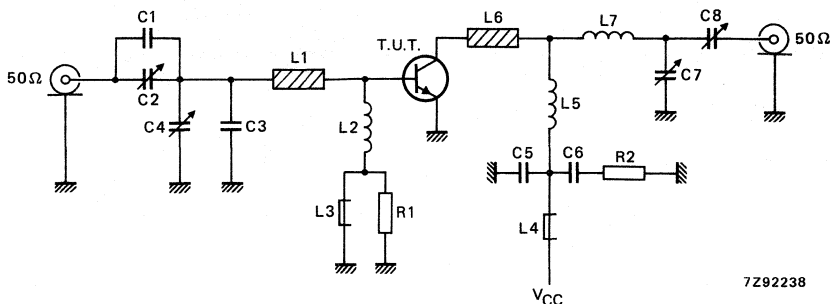


Fig. 6  $I_E = i_e = 0$ ;  $f = 1$  MHz; typ. values.

## APPLICATION INFORMATION (part I)

R.F. performance in c.w. operation (common-emitter class-B circuit) at  $f = 470$  MHz;  $T_h = 25$  °C.

mode of operation	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta_C$ %
narrow band; c.w.	12,5	5	< 0,45 typ. 0,32	> 10,5 typ. 12	< 0,665 typ. 0,60	> 60 typ. 66

Fig. 7 Class-B test circuit at  $f = 470$  MHz.

## List of components:

C1 = 2,7 pF multilayer ceramic chip capacitor\*

C2 = C7 = C8 = 1,4-5,5 pF film dielectric trimmer (cat.no. 2222 809 09001)

C3 = 7,5 pF multilayer ceramic chip capacitor\*

C4 = 2-9 pF film dielectric trimmer (cat.no. 2222 809 09002)

C5 = 100 pF multilayer ceramic chip capacitor (cat. no. 2222 852 13101)

C6 = 100 nF metallized film capacitor (cat. no. 2222 352 45104)

L1 = stripline, 22,5 mm x 6,0 mm

L2 = 1 turn Cu-wire (1,0 mm), int. dia. 5,5 mm, leads 2 x 5 mm

L3 = L4 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)

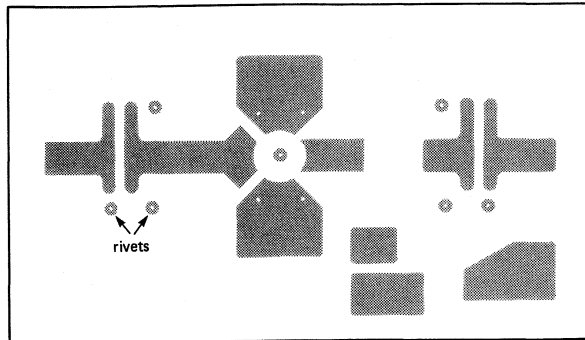
L5 = 4 turns enamelled Cu-wire (1,0 mm), int. dia. 6 mm, length 7,5 mm, leads 2 x 5 mm

L6 = stripline, 10,0 mm x 6,0 mm

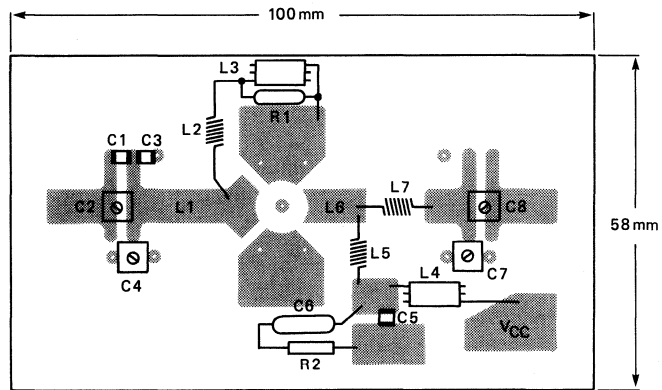
L7 = 1 turn Cu-wire (1,0 mm), int. dia. 5 mm, leads 2 x 5 mm

R1 = R2 = 10  $\Omega$  metal film resistor, 0,25 WL1 and L6 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,74$ ) and a thickness of 1/16 inch.

\* American Technical Ceramics capacitor type 100 A or capacitor of same quality.



7Z90362



7Z90361

Fig. 8 Printed circuit board and component layout for 470 MHz.

The circuits and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper to serve as ground plane. Earth connections are made by hollow rivets.

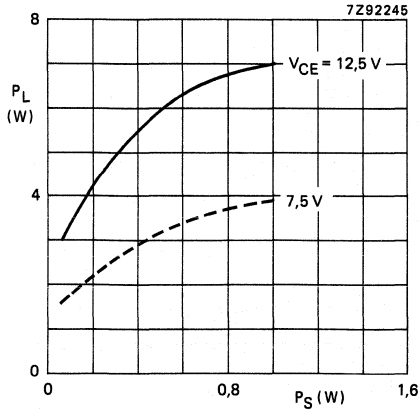


Fig. 9 Output power.

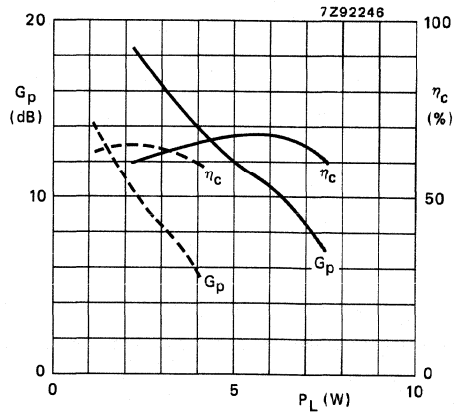


Fig. 10 Power gain and efficiency;

— :  $V_{CE} = 12.5\text{ V}$   
 - - - :  $V_{CE} = 7.5\text{ V}$ .

Conditions for Figs 9 and 10:

$f = 470\text{ MHz}$ ; class-B operation;  $T_h = 25\text{ }^\circ\text{C}$ ; typ. values.

**RUGGEDNESS:**

The device is capable of withstanding a load mismatch with  $V_{SWR} = 50$  (all phases) up to a supply voltage of 15.5 V at rated load power.

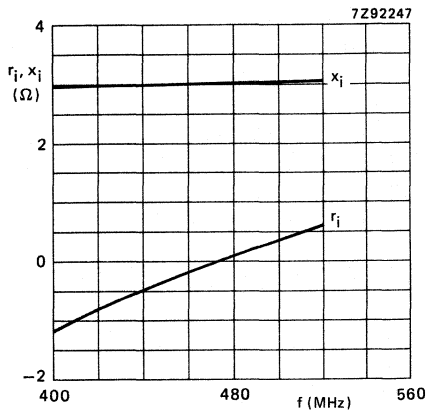


Fig. 11 Input impedance (series components).

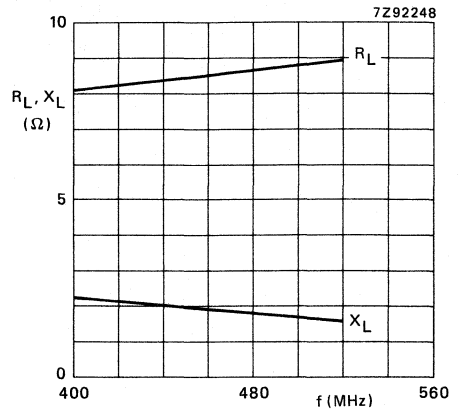


Fig. 12 Load impedance (series components).

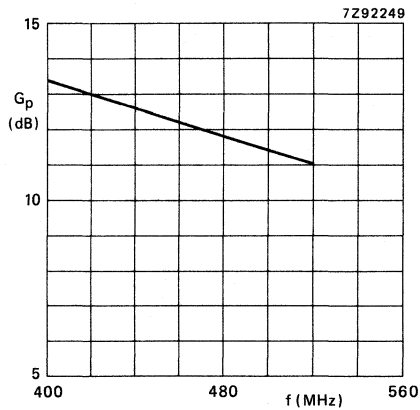


Fig. 13 Power gain.

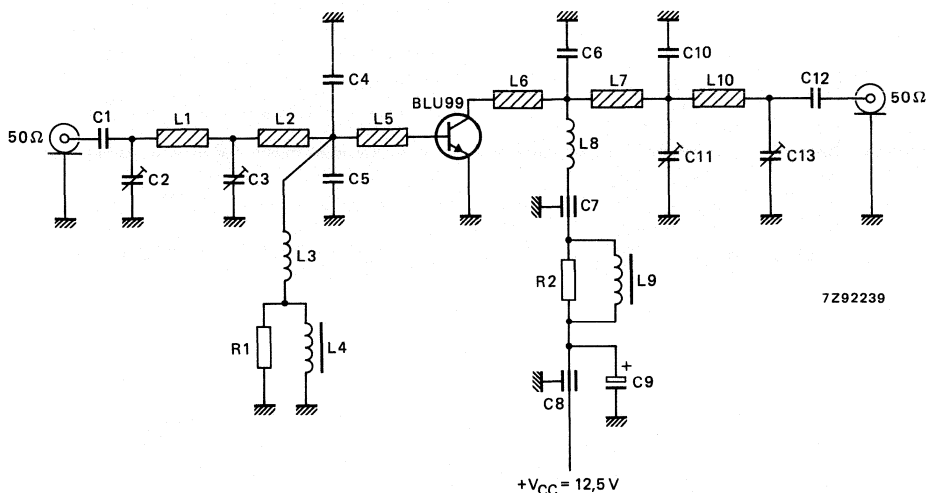
Conditions for Figs 11, 12 and 13:

$V_{CE} = 12,5 \text{ V}$ ;  $P_L = 5 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f = 400\text{-}520 \text{ MHz}$ ; typical values.

## APPLICATION INFORMATION (part II)

R.F. performance in c.w. operation (common-emitter class-B circuit) at  $f = 900$  MHz;  $T_h = 25$  °C

mode of operation	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta_C$ %
narrow band; c.w.	12,5	4	typ. 0,8	typ. 7,0	typ. 0,54	typ. 60

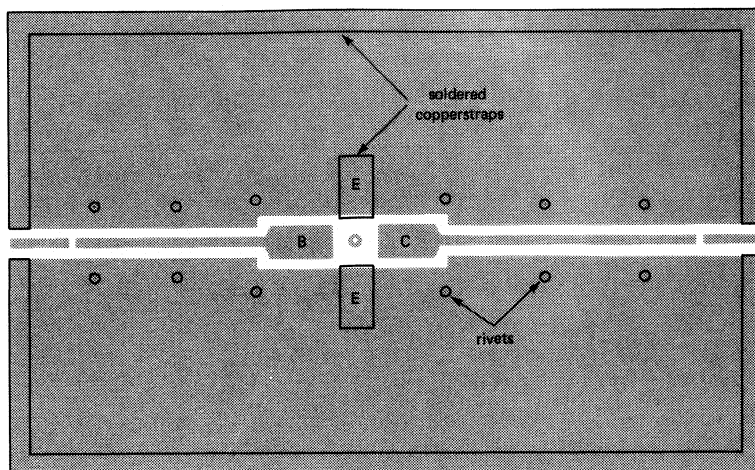
Fig. 14 Class-B test circuit at  $f = 900$  MHz.

## List of components:

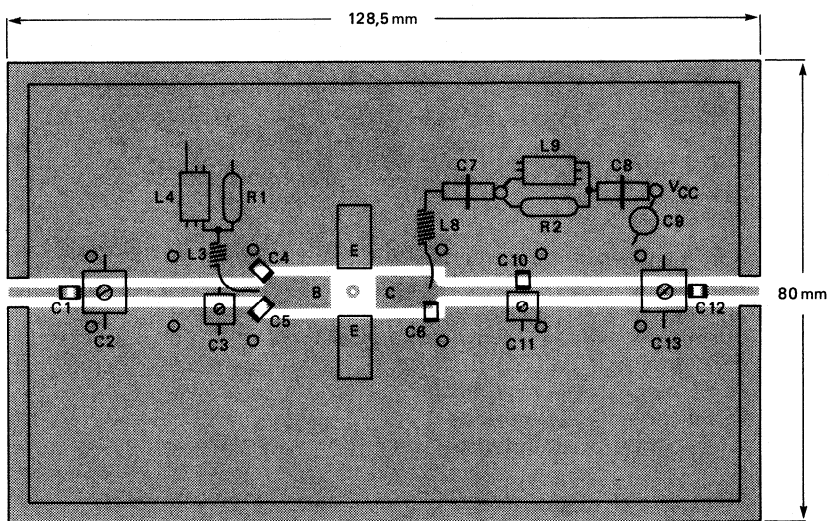
- C1 = C12 = 33 pF multilayer ceramic chip capacitor\*
- C2 = C13 = 1,4-5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C3 = C11 = 1,2-3,5 pF film dielectric trimmer (cat. no. 2222 809 05001)
- C4 = C5 = C10 = 6,2 pF multilayer ceramic chip capacitor\*
- C6 = 1 pF multilayer ceramic chip capacitor\*
- C7 = 10 pF ceramic feed-through capacitor
- C8 = 330 pF ceramic feed-through capacitor
- C9 = 2,2  $\mu$ F tantalum electrolytic capacitor
- L1 = stripline, 21,0 mm  $\times$  1,85 mm
- L2 = stripline, 5,0 mm  $\times$  1,85 mm
- L3 = 60 nH, 4 turns enamelled Cu-wire (0,4 mm), close wound, int. dia. 3 mm
- L4 = L9 = Ferroxcube wideband h.f. choke, grade 3B (cat. no 4312 020 36642)
- L5 = stripline, 11,3 mm  $\times$  6,0 mm
- L6 = stripline, 10,0 mm  $\times$  6,0 mm
- L7 = stripline, 15,9 mm  $\times$  1,85 mm
- L8 = 280 nH, 15 turns enamelled Cu-wire (0,4 mm), close wound, int. dia. 3 mm
- L10 = stripline, 28,0 mm  $\times$  1,85 mm
- R1 = R2 = 10  $\Omega$  metal film resistor, 0,25 W

L1, L2, L5, L6, L7 and L10 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,74$ ) and thickness of 1/32 in.

\* American Technical Ceramics capacitor type 100 A or capacitor of same quality.



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7Z90364

Fig. 15 Printed circuit board and component layout for a 900 MHz test circuit.

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper to serve as a ground plane. Earth connections are made by hollow rivets and also by fixing screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the ground plane.

#### RUGGEDNESS

The device is capable of withstanding a load mismatch with  $VSWR = 50$  (all phases) up to a supply voltage of 15,5 V at rated load power.



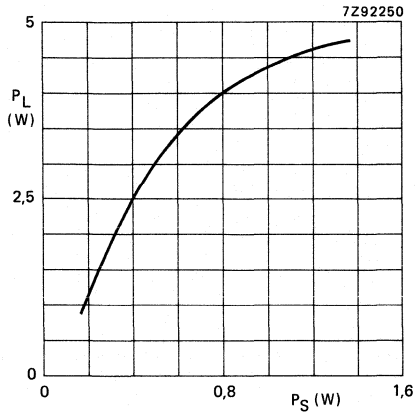


Fig. 16 Output power.

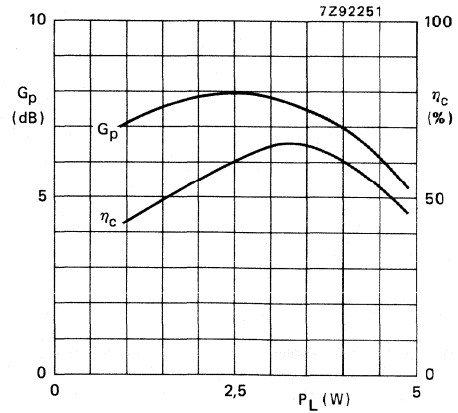


Fig. 17 Power gain and efficiency.

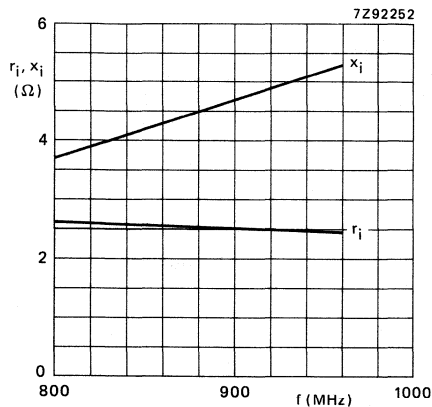


Fig. 18 Input impedance (series components).

Conditions for Figs 16 and 17:  
 $f = 900 \text{ MHz}$ ;  $V_{CE} = 12,5 \text{ V}$ ; class-B operation;  
 $T_h = 25 \text{ }^\circ\text{C}$ ; typ. values.

Conditions for Figs 18 and 19:  
 $f = 800\text{-}960 \text{ MHz}$ ;  $V_{CE} = 12,5 \text{ V}$ ;  $P_L = 4 \text{ W}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ ; typ. values.

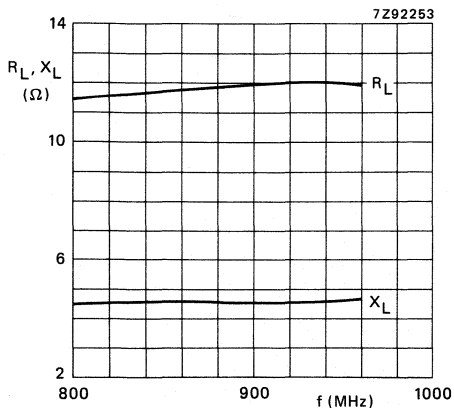


Fig. 19 Load impedance (series components).

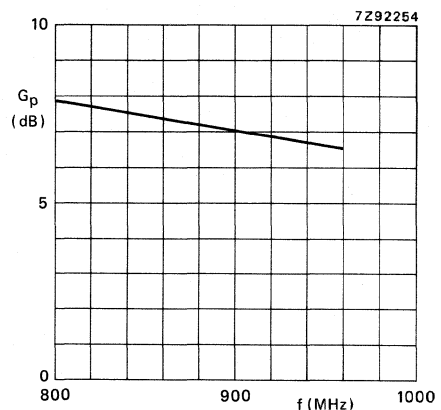


Fig. 20 Power gain.



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile, h.f. and v.h.f. transmitters with a nominal supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

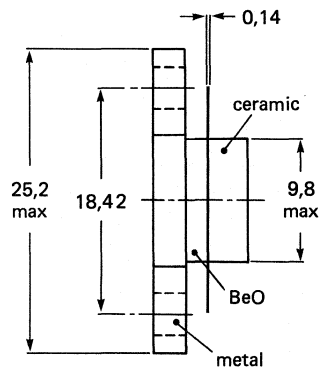
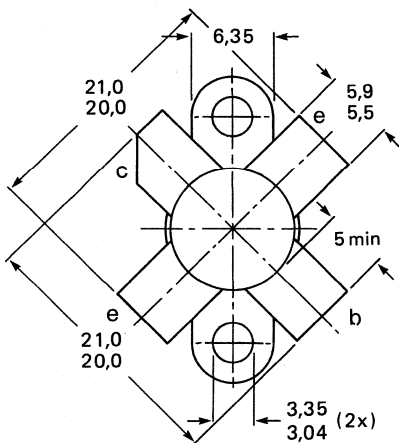
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	8	> 9,0	> 70	$2,8 + j1,2$	$76 - j16$
c.w.	12,5	175	8	typ. 10,5	typ. 75	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.

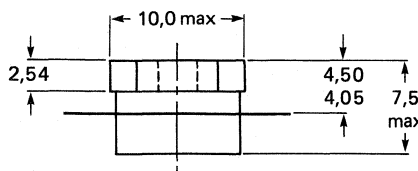


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Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value

$V_{CESM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_{C(AV)}$  max. 1,5 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 4,0 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 20 W

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

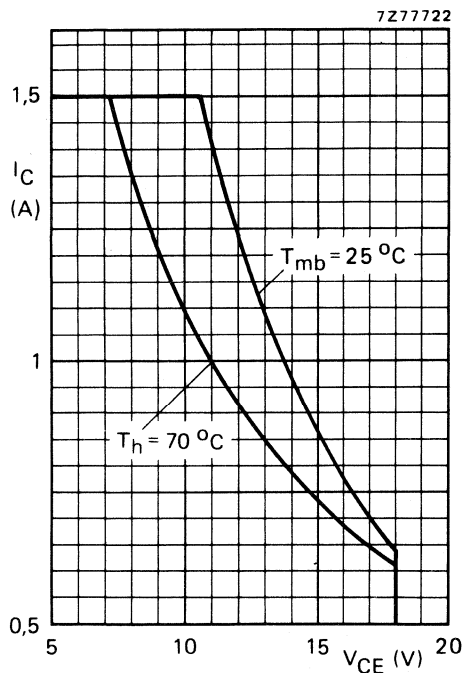


Fig. 2 D.C. SOAR.

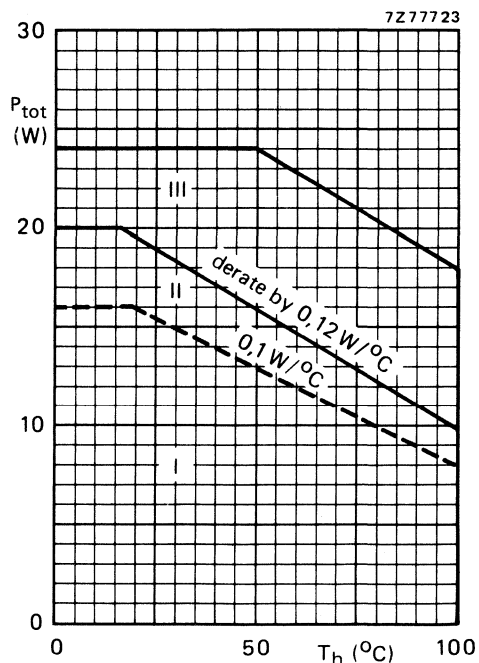


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 8 W;  $T_{mb} = 72,4$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th j-mb(dc)}$  = 10,7 K/W

From junction to mounting base (r.f. dissipation)

$R_{th j-mb(rf)}$  = 8,6 K/W

From mounting base to heatsink

$R_{th mb-h}$  = 0,3 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 5\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 25\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 1\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 2\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 0,5\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $E_{SBR} > 0,5\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,75\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 2\text{ A}; I_B = 0,4\text{ A}$  $V_{CEsat}$  typ. 0,85 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 0,75\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 950 MHz $-I_E = 2\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 850 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 13,5\text{ V}$  $C_c$  typ. 16,5 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 13,5\text{ V}$  $C_{re}$  typ. 12 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

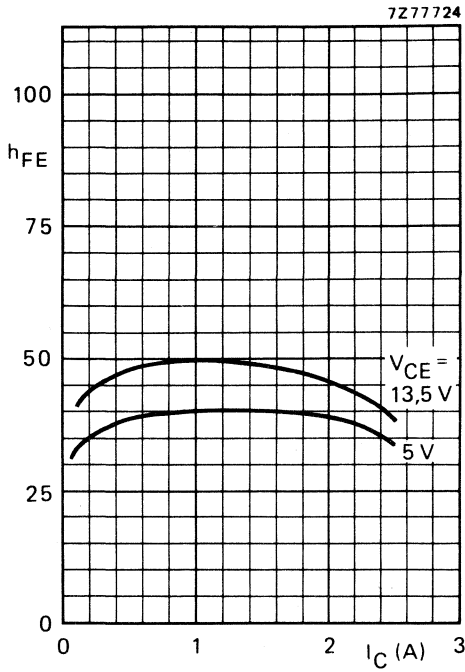


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

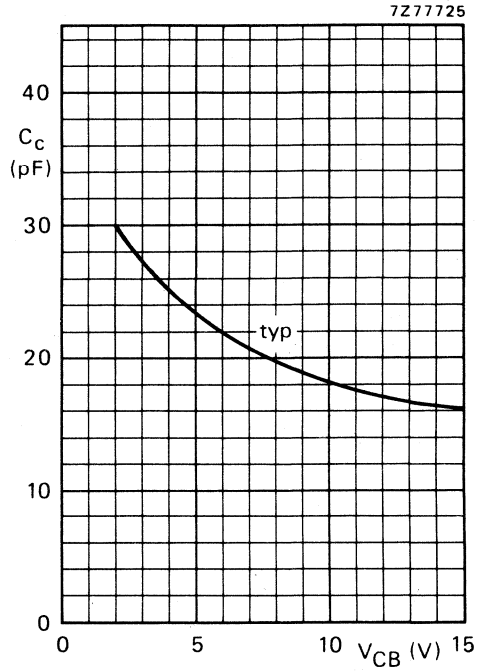


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

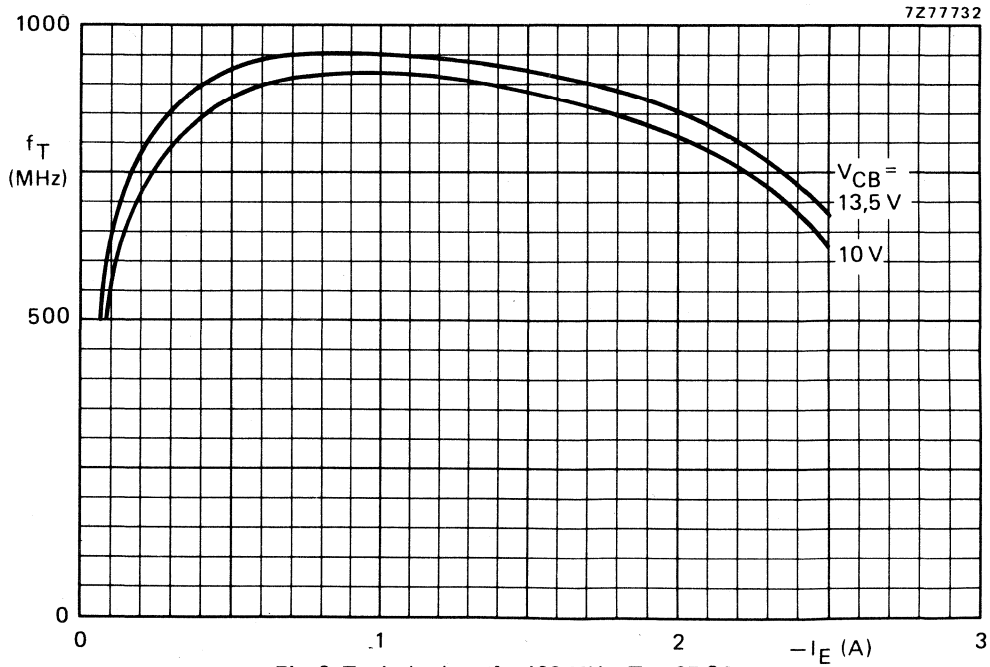


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	13,5	8	< 1,0	> 9,0	< 0,85	> 70	$2,8 + j1,2$	$76 - j16$
175	12,5	8	—	typ. 10,5	—	typ. 75	—	—

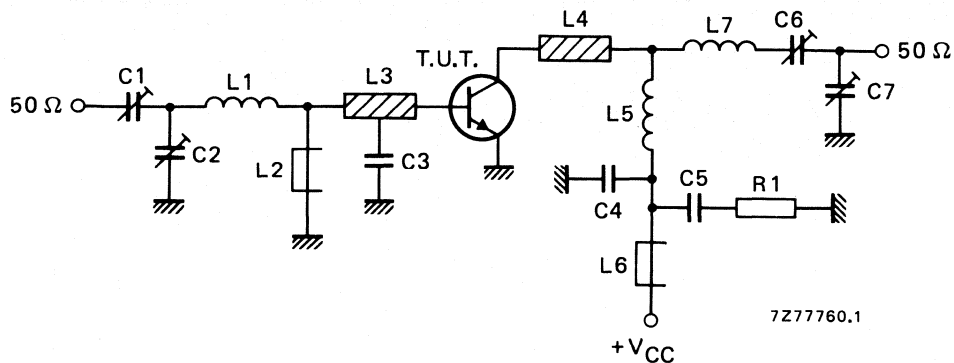


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 2 turns Cu wire (1,6 mm); int. dia. 4,5 mm; length 5,7 mm; leads 2 x 5 mm

L2 = L6 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L4 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

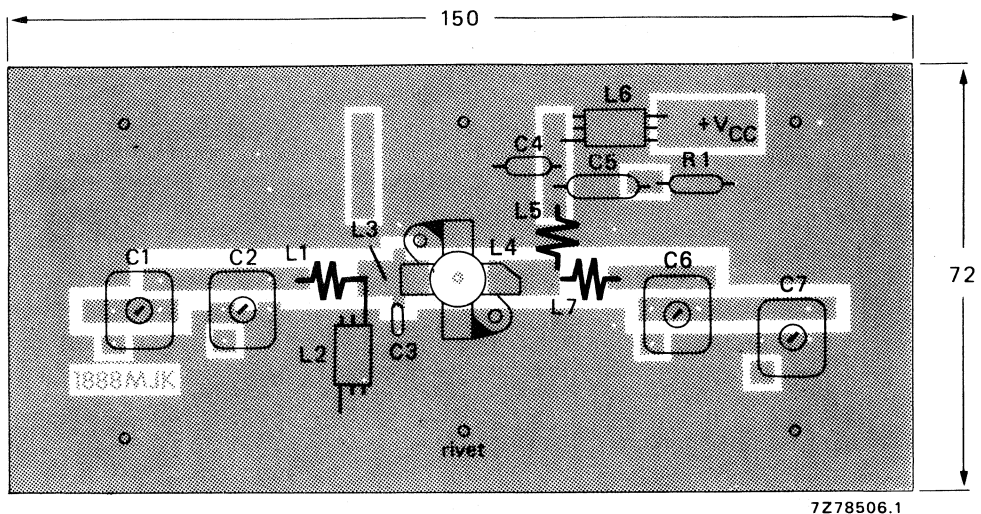
L5 = 3 turns Cu wire (1,6 mm); int. dia. 7,5 mm; length 7,5 mm; leads 2 x 5 mm

L7 = 3 turns Cu wire (1,6 mm); int. dia. 6,5 mm; length 7,4 mm; leads 2 x 5 mm

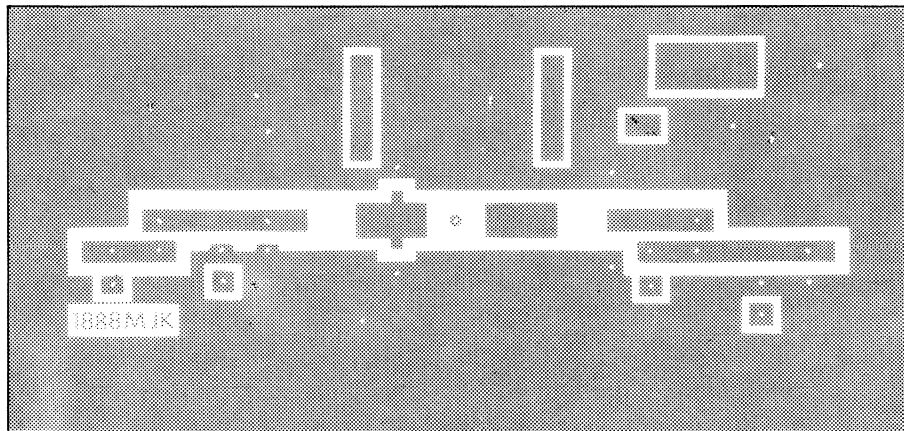
L3 and L4 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.



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Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.



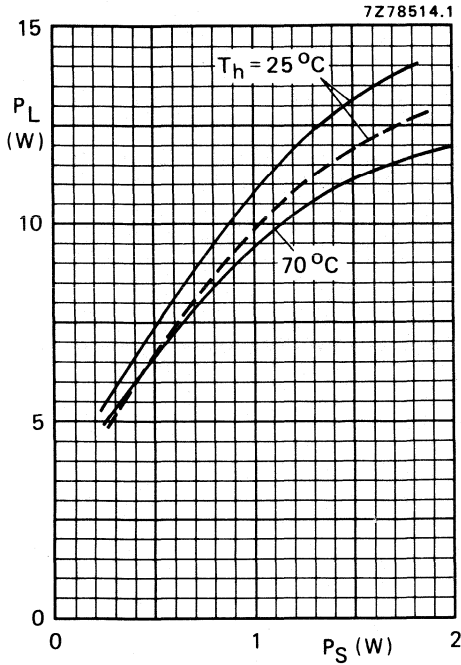


Fig. 9 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 13,5 \text{ V}$ ; ---  $V_{CE} = 12,5 \text{ V}$ .  
 7Z78511

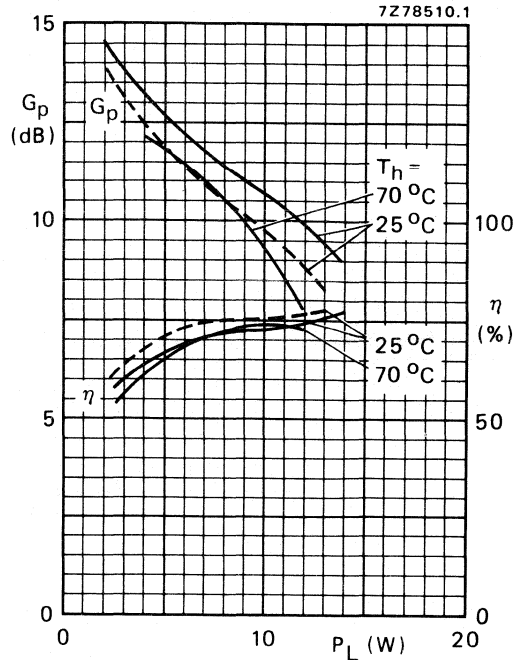


Fig. 10 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 13,5 \text{ V}$ ; ---  $V_{CE} = 12,5 \text{ V}$ .

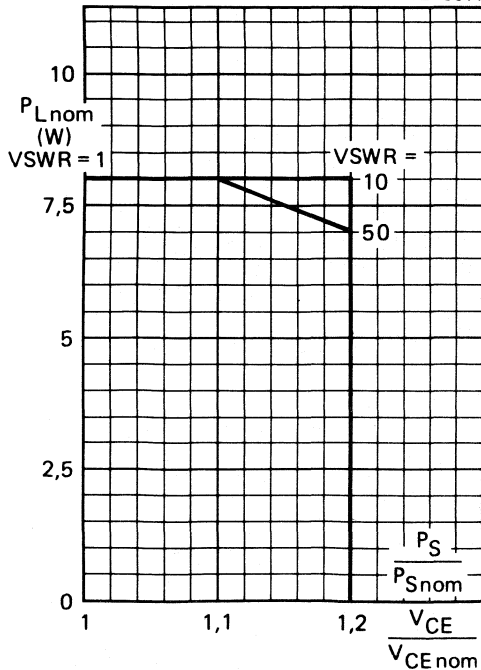


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  
 $R_{th \text{ mb-h}} = 0,3 \text{ K/W}$ ;  $V_{CE \text{ nom}} = 13,5 \text{ V}$  or  $12,5 \text{ V}$ ;  $P_S = P_{S \text{ nom}}$  at  $V_{CE \text{ nom}}$  and  $V_{SWR} = 1$ .

Note to Fig. 11:

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $V_{SWR} = 1$ ), as a function of the expected supply over-voltage ratio with  $V_{SWR}$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{S \text{ nom}}$ ) increases linearly with supply over-voltage ratio.

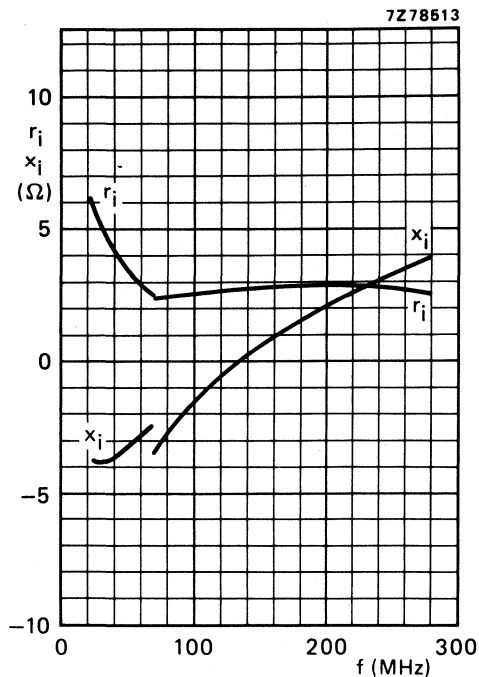


Fig. 12 Input impedance (series components).

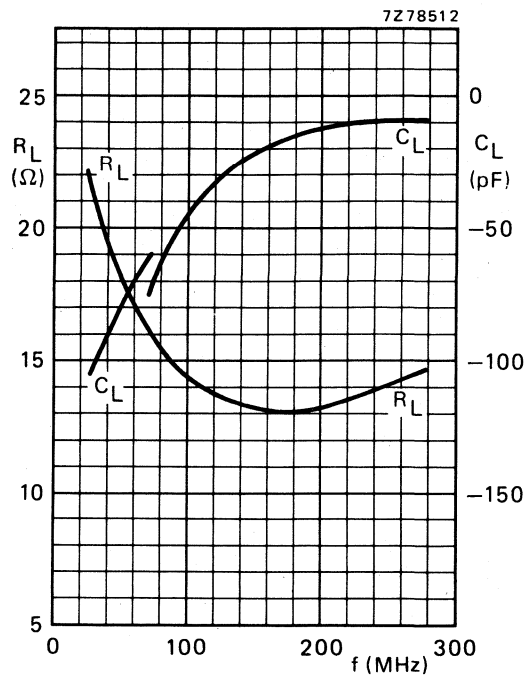


Fig. 13 Load impedance (parallel components).

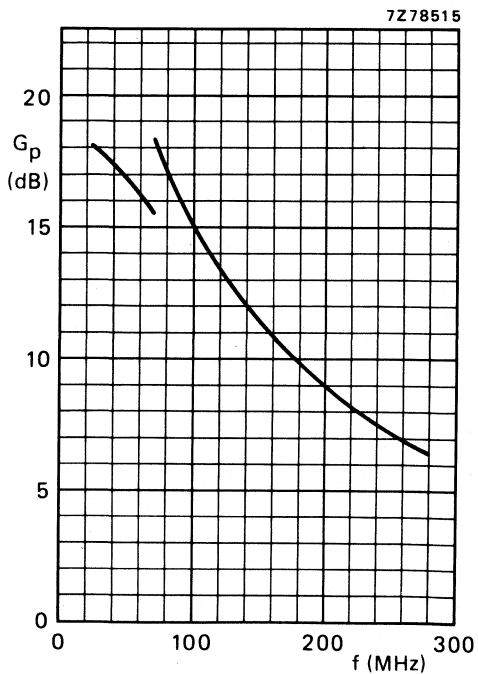


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 13,5 \text{ V}$ ;  $P_L = 8 \text{ W}$ ;

$T_h = 25 \text{ }^\circ\text{C}$ .

**OPERATING NOTE**

Below 70 MHz a base-emitter resistor of  $10 \text{ } \Omega$  is recommended to avoid oscillation.

This resistor must be effective for r.f. only.

## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile, h.f. and v.h.f. transmitters with a nominal supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

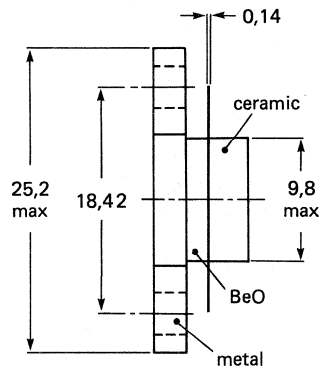
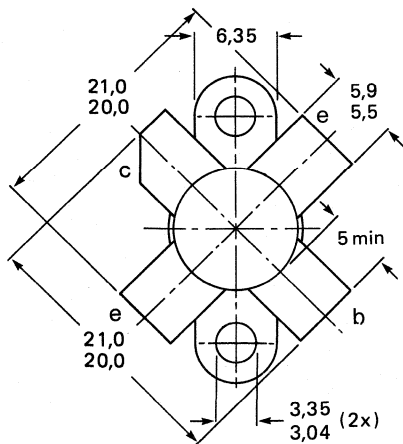
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	15	> 8,0	> 60	2,3 + j2,2	130 - j4,4
c.w.	12,5	175	15	typ. 7,5	typ. 67	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.

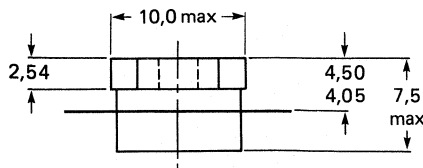


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Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	3 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	8 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	36 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

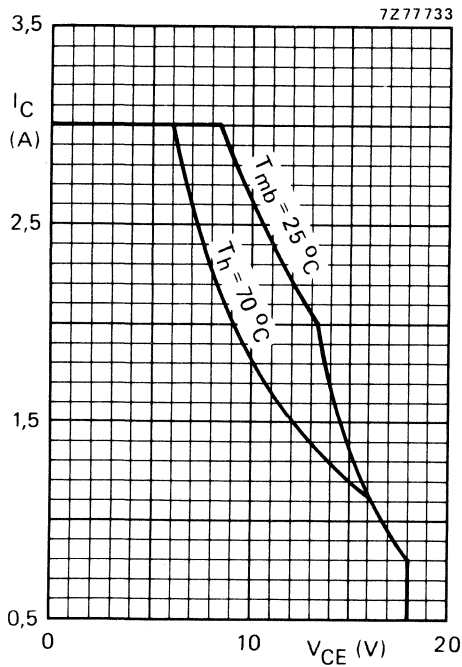


Fig. 2 D.C. SOAR.

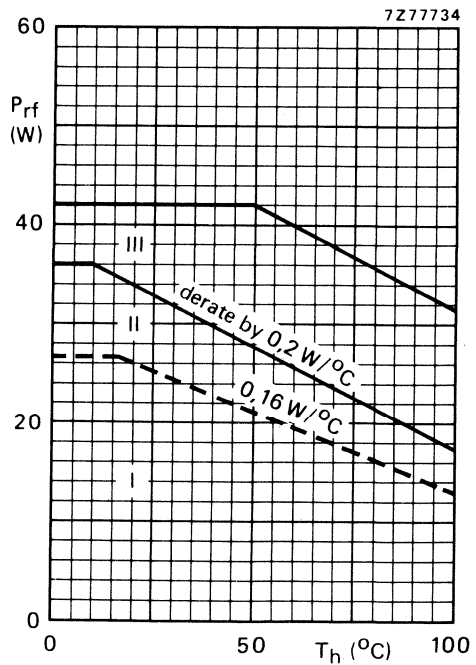


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 15 W;  $T_{mb} = 74,5$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	6,55 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	4,95 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,3 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 4\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 4\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $ESBO > 2,5\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $ESBR > 2,5\text{ mJ}$ 

D.C. current gain \*

 $I_C = 1,5\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 4,5\text{ A}; I_B = 0,9\text{ A}$  $V_{CEsat}$  typ. 1,0 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 1,5\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 850 MHz $-I_E = 4,5\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 800 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 13,5\text{ V}$  $C_c$  typ. 32 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 200\text{ mA}; V_{CE} = 13,5\text{ V}$  $C_{re}$  typ. 23 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

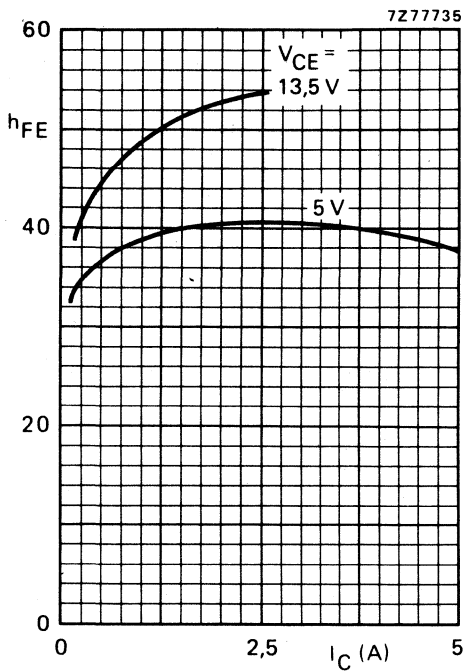


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

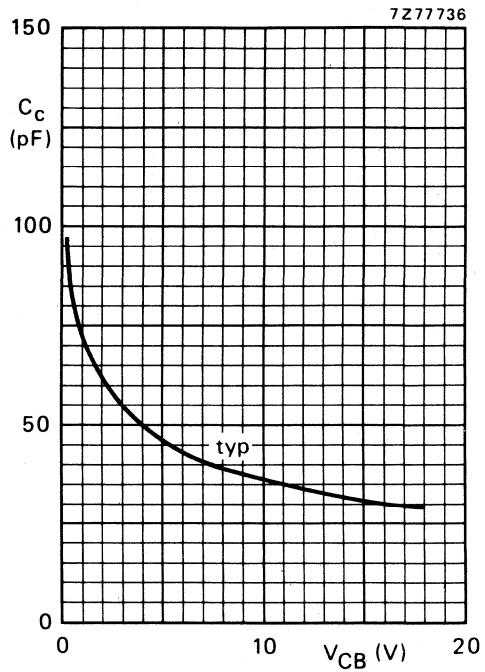


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

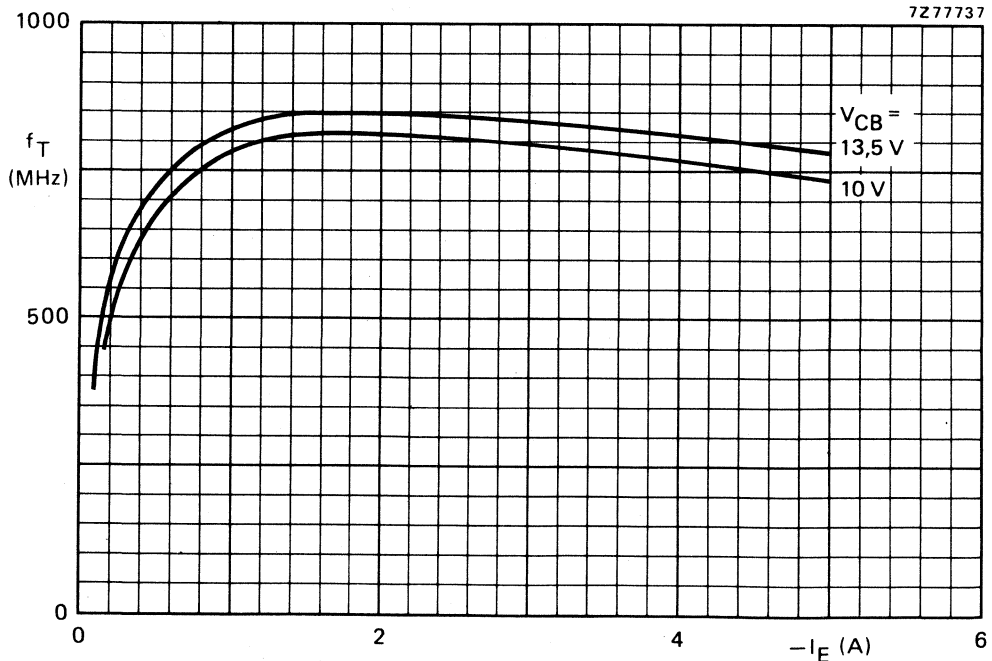


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	13,5	15	< 2,4	> 8,0	< 1,85	> 60	2,3 + j2,2	130 - j4,4
175	12,5	15	-	typ. 7,5	-	typ. 67	-	-

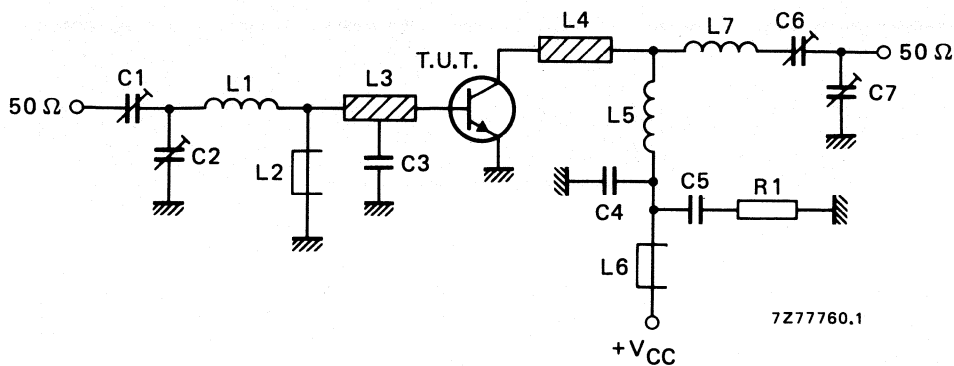


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 2 turns Cu wire (1,6 mm); int. dia. 4,5 mm; length 5,7 mm; leads 2 x 5 mm

L2 = L6 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L4 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

L5 = 3 turns Cu wire (1,6 mm); int. dia. 7,5 mm; length 7,5 mm; leads 2 x 5 mm

L7 = 3 turns Cu wire (1,6 mm); int. dia. 6,5 mm; length 7,4 mm; leads 2 x 5 mm

L3 and L4 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.

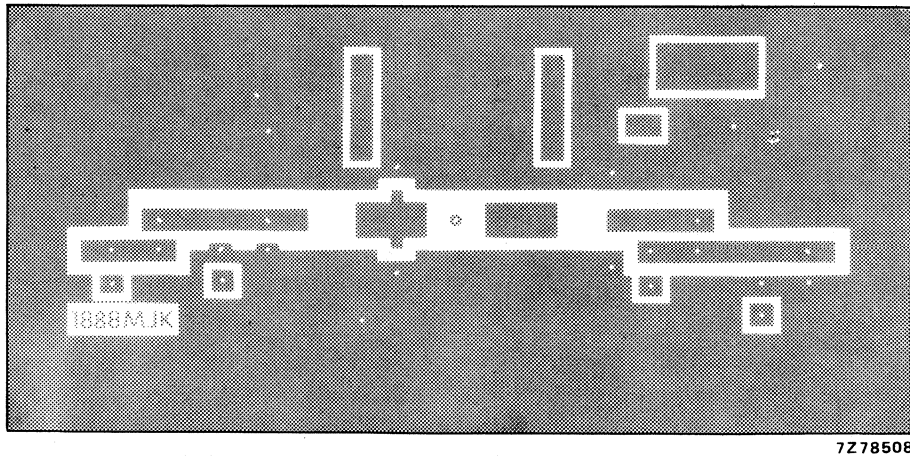
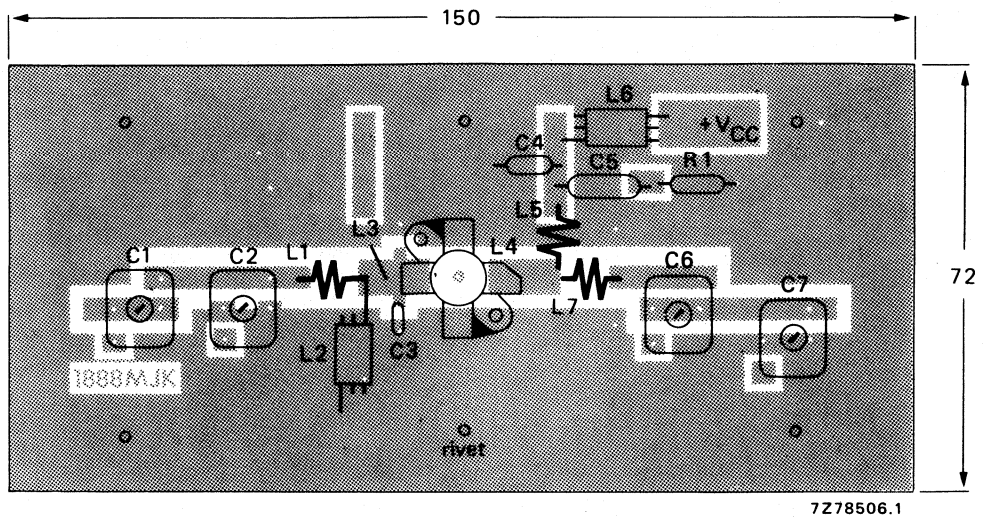


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.



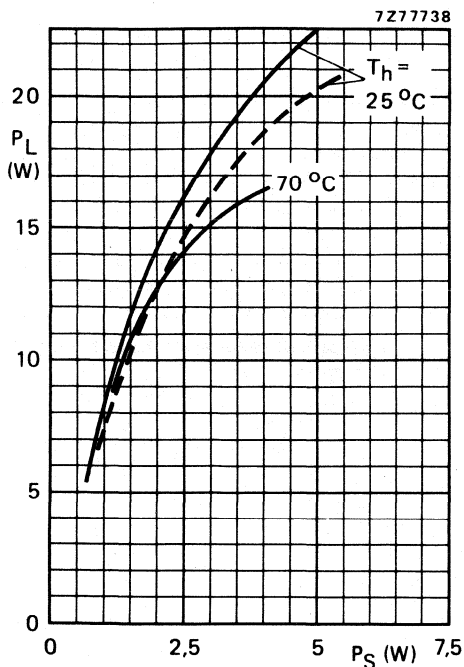


Fig. 9 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 13,5 \text{ V}$ ; - - -  $V_{CE} = 12,5 \text{ V}$ .

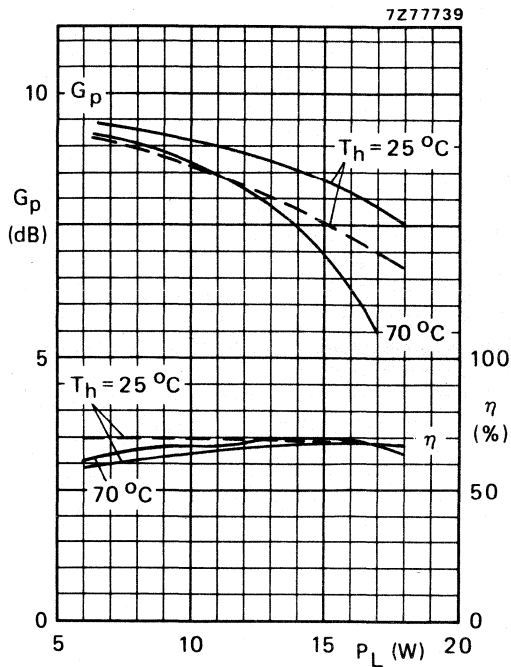


Fig. 10 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 13,5 \text{ V}$ ; - - -  $V_{CE} = 12,5 \text{ V}$ .

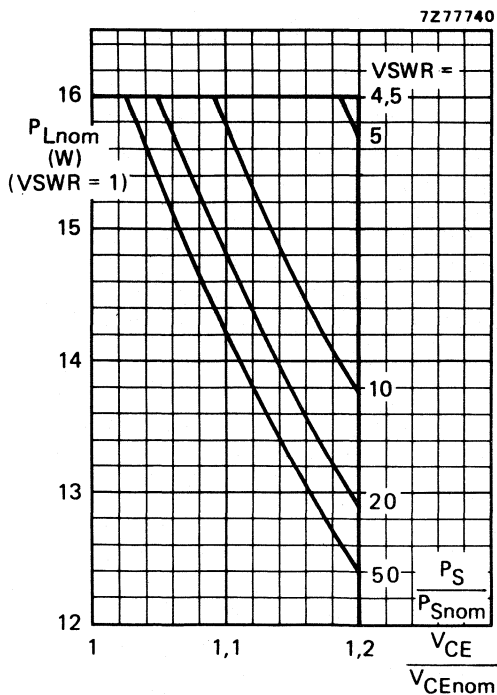


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  
 $R_{th \text{ mb-h}} = 0,3 \text{ K/W}$ ;  $V_{CEnom} = 13,5 \text{ V}$  or  $12,5 \text{ V}$ ;  $P_S = P_{Snom}$  at  $V_{CEnom}$  and  $VSWR = 1$ .

Note to Fig. 11:

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ), as a function of the expected supply over-voltage ratio with  $VSWR$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

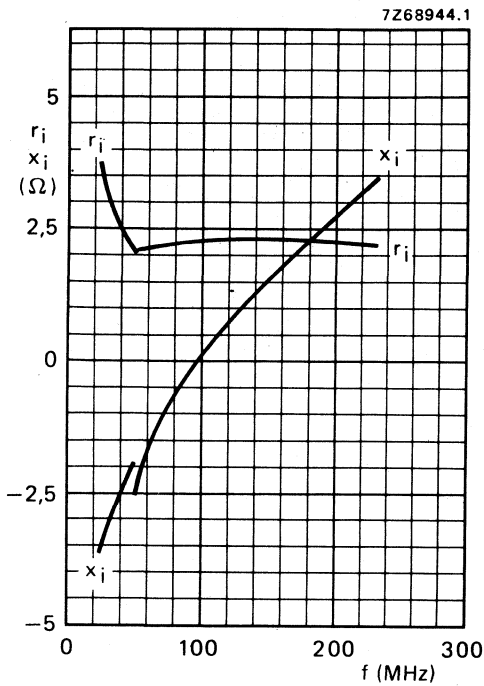


Fig. 12 Input impedance (series components).

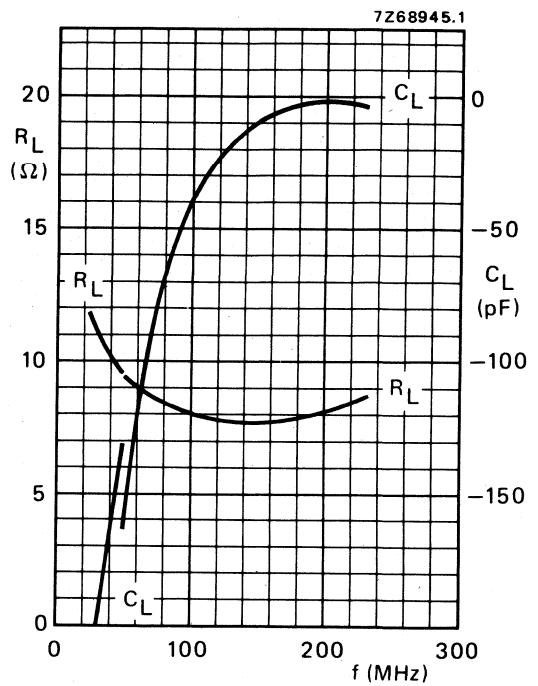
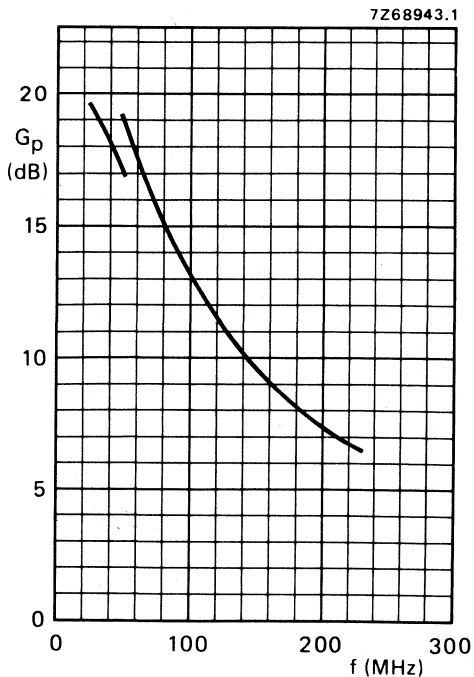


Fig. 13 Load impedance (parallel components).



Conditions for Figs 12, 13 and 14:

Typical values:  $V_{CE} = 13,5 \text{ V}$ ;  $P_L = 15 \text{ W}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ .

**OPERATING NOTE**

Below 50 MHz a base-emitter resistor of  $10 \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

Fig. 14.

Data sheet	
status	Preliminary specification
date of issue	October 1990

# BLV12

## VHF power transistor

### DESCRIPTION

NPN silicon planar epitaxial transistor in a SOT123 envelope, intended for use in class-A, B and C operated mobile VHF transmitters with a supply voltage of 12.5 V. The transistor has a 4-lead flange envelope, with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

RF performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common emitter circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
c.w. class-B	175	12.5	30	> 9	> 60

### MECHANICAL DATA

SOT123 - see Fig.1.

### WARNING

#### Product and environmental safety - toxic materials

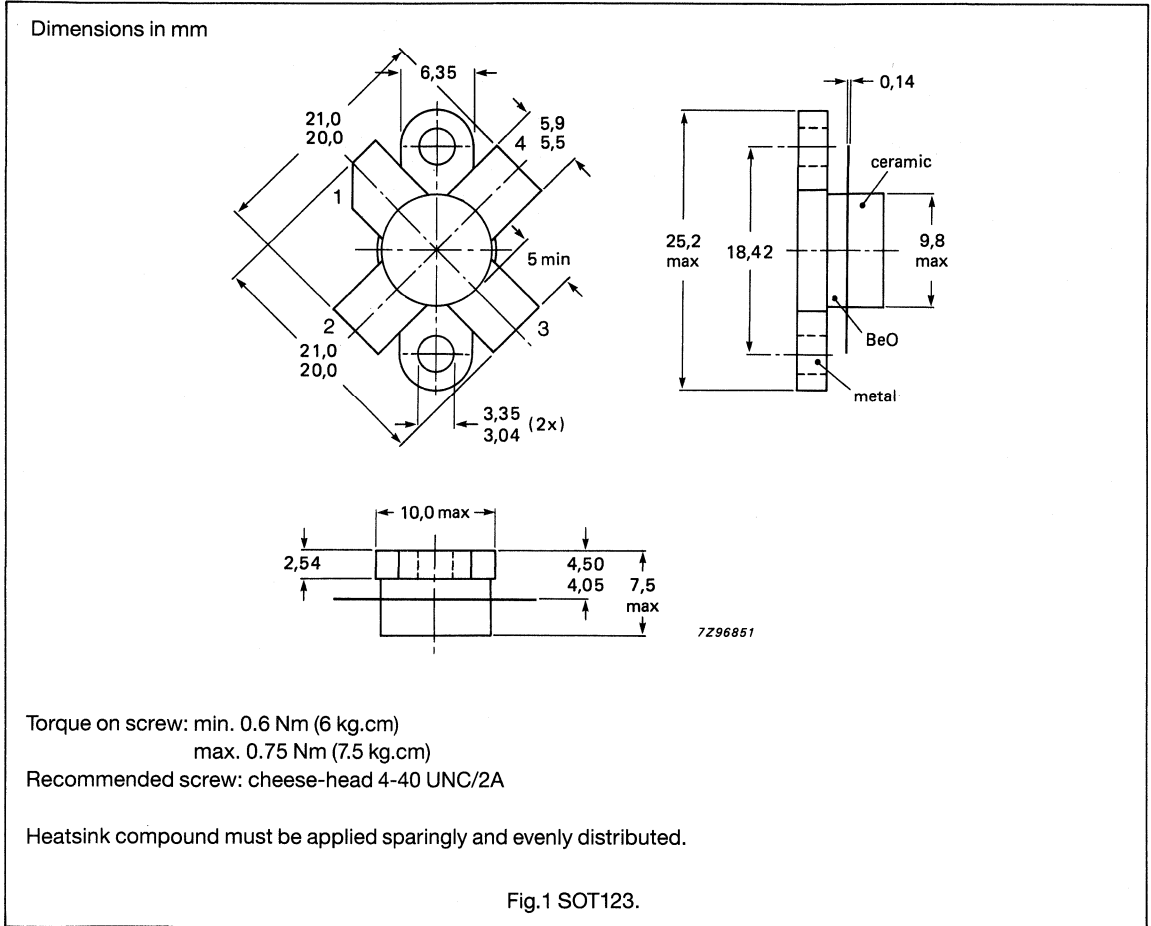
**This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions.**

**After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.**

VHF power transistor

BLV12

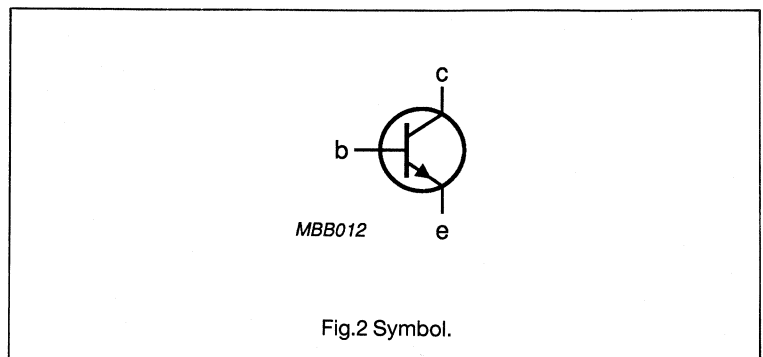
MECHANICAL DATA



PINNING

PIN	DESCRIPTION
1	collector
2	emitter
3	base
4	emitter

PIN CONFIGURATION



**VHF power transistor****BLV12****LIMITING VALUES**

In accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CB0</sub>	collector base voltage	open emitter	-	36	V
V <sub>CEO</sub>	collector emitter voltage	open base	-	16	V
V <sub>EBO</sub>	emitter base voltage	open collector	-	3	V
I <sub>C</sub>	collector current	DC or average	-	6	A
I <sub>CM</sub>	collector current	peak value f > 1 MHz	-	15	A
P <sub>tot</sub>	total power dissipation	f > 1 MHz T <sub>mb</sub> = 25 °C	-	96	W
T <sub>stg</sub>	storage temperature range		-65	150	°C
T <sub>j</sub>	operating junction temperature		-	200	°C

**THERMAL RESISTANCE**Dissipation = 48 W, T<sub>mb</sub> = 25 °C.

SYMBOL	PARAMETER	CONDI- TIONS	TYP.	MAX.*	UNIT
R <sub>th j-mb(DC)</sub>	from junction to mounting base (DC)		-	2.0	K/W
R <sub>th j-mb(RF)</sub>	from junction to mounting base (RF)		-	1.5	K/W
R <sub>th mb-h</sub>	from mounting base to heatsink		-	0.3	K/W

**CHARACTERISTICS**

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	open emitter I <sub>C</sub> = 10 mA	36	-	-	V
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	open base I <sub>C</sub> = 25 mA	16	-	-	V
V <sub>(BR)EBO</sub>	emitter-base breakdown voltage	open collector I <sub>E</sub> = 1 mA	3	-	-	V
I <sub>CES</sub>	collector-emitter leakage current	V <sub>BE</sub> = 0 V <sub>CE</sub> = 18 V	-	-	10	mA
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 4 A V <sub>CE</sub> = 5 V	25	-	110	
C <sub>c</sub>	collector capacitance at f = 1 MHz	I <sub>E</sub> = I <sub>e</sub> = 0 V <sub>CB</sub> = 12.5 V	-	87	-	pF
C <sub>cf</sub>	collector-flange capacitance		-	2	-	pF

**APPLICATION INFORMATION**

RF performance in a common emitter test circuit at

T<sub>h</sub> = 25 °C, R<sub>th mb-h</sub> = 0.3 K/W, unless otherwise specified.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>P</sub> (dB)	η <sub>c</sub> (%)
c.w. class-B	175	12.5	30	> 9	> 60

## VHF power transistor

## BLV12

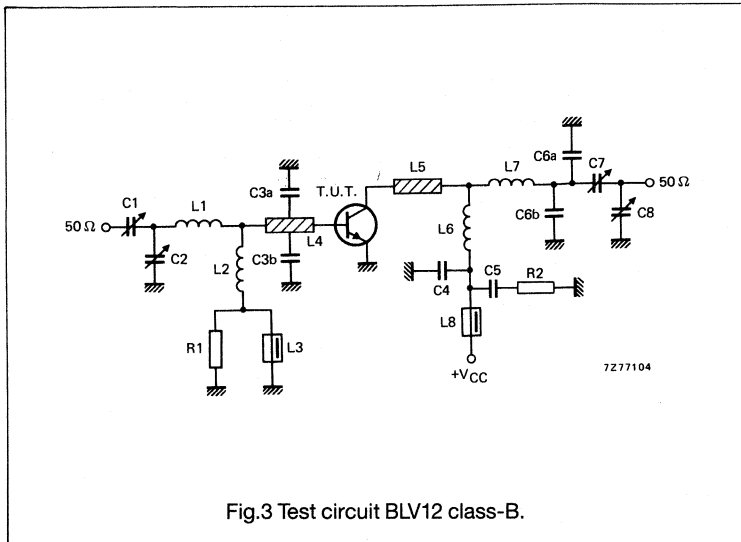


Fig.3 Test circuit BLV12 class-B.

**Ruggedness in class-B operation**

The BLV12 is capable of withstanding a load mismatch corresponding to  $VSWR = 50$  through all phases, up to a supply voltage of 15.5 V, ( $P_L = 30$  W and  $f = 175$  MHz).

**List of components (Fig. 3)**

DESIGNATION	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	film dielectric trimmer	2.5 to 20 pF		2222 809 07004
C2, C8	film dielectric trimmer	4 to 40 pF		2222 809 07008
C3a, C3b	500 V ceramic capacitor	47 pF		
C4	500 V ceramic capacitor	120 pF		
C5	polyester capacitor	100 nF		
C6a, C6b	500 V ceramic capacitor	8.2 pF		
C7	film dielectric trimmer	5 to 60 pF		2222 809 07011
L1	1 turn 1.6 mm copper wire		int. dia. 9 mm leads 2 x 5 mm	
L2	7 turns 0.5 mm closely wound enameled copper wire	100 nH	int. dia. 3 mm leads 2 x 5 mm	
L3, L8	grade 3B Ferroxcube wide-band HF choke			4312 020 36640
L4, L5	stripline note 1		12 x 6 mm	
L6	2 turns 1.6 mm copper wire		int. dia. 5 mm length 6 mm leads 2 x 5 mm	
L7	2 turns 1.6 mm copper wire		int. dia. 4.5 mm length 6 mm leads 2 x 5 mm	
R1	0.25 W, $\pm 10\%$ carbon resistor	10 $\Omega$		
R2	0.25 W $\pm 5\%$ carbon resistor	4.7 $\Omega$		

**Notes**

- L4 and L5 are strips on a double copper-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16 inch. Taps for C3a and C3b at 5 mm from the transistor.

**VHF power transistor****BLV12**

The circuit and components are located on one side of the epoxy fibre-glass board, the other side being fully metallized, to serve as an earth. Earth connections are made by hollow rivets and copper straps under the emitters, to provide a direct contact between the component side and the ground plane.

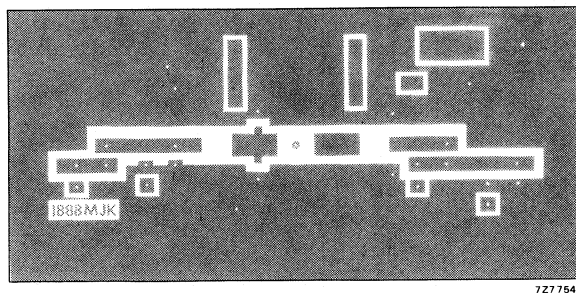
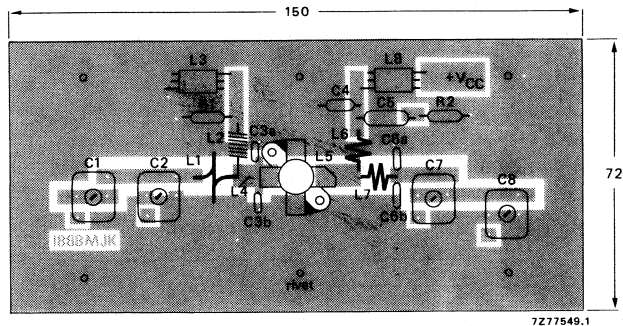


Fig.4 Printed circuit board and component layout for 175 MHz test circuit.

VHF power transistor

BLV12

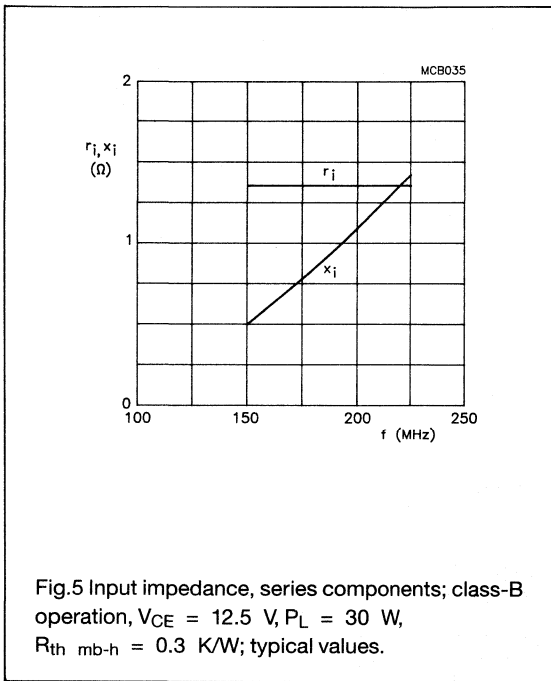


Fig.5 Input impedance, series components; class-B operation,  $V_{CE} = 12.5$  V,  $P_L = 30$  W,  $R_{th\ mb-h} = 0.3$  K/W; typical values.

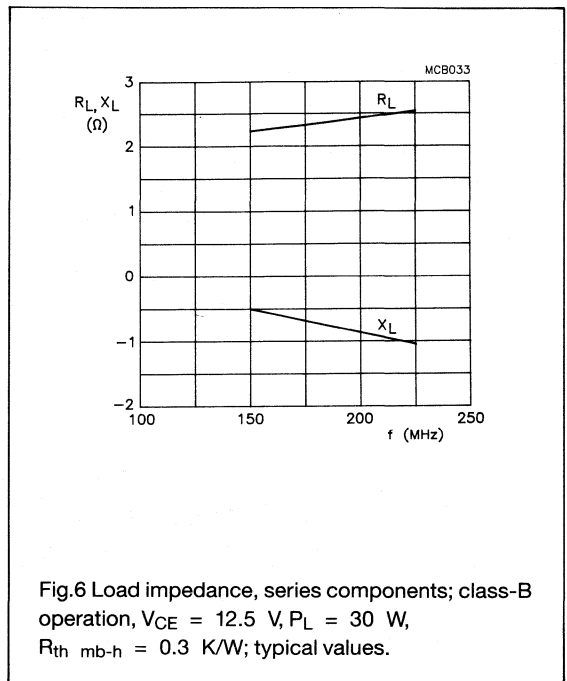


Fig.6 Load impedance, series components; class-B operation,  $V_{CE} = 12.5$  V,  $P_L = 30$  W,  $R_{th\ mb-h} = 0.3$  K/W; typical values.

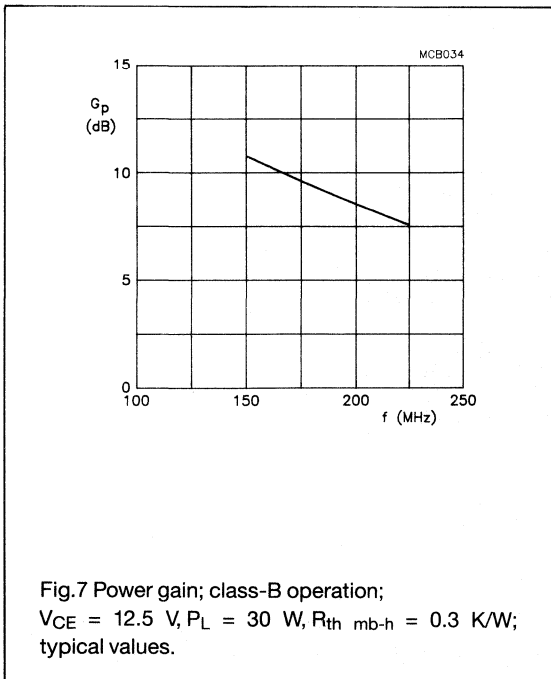


Fig.7 Power gain; class-B operation;  $V_{CE} = 12.5$  V,  $P_L = 30$  W,  $R_{th\ mb-h} = 0.3$  K/W; typical values.



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated h.f. and v.h.f. transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

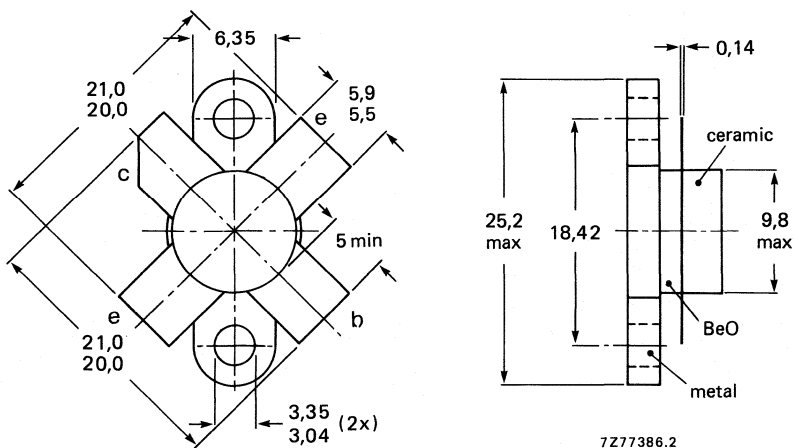
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	8	> 12	> 65	$1,8 + j0,7$	$18 - j20$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.



7Z77386.2

Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	0,9 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	2,5 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	20 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

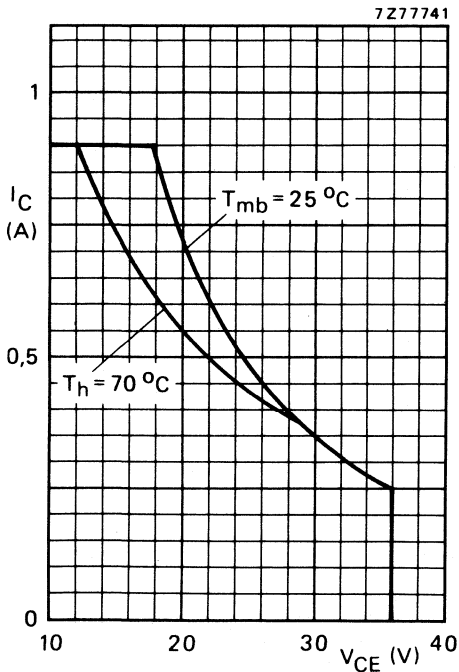


Fig. 2 D.C. SOAR.

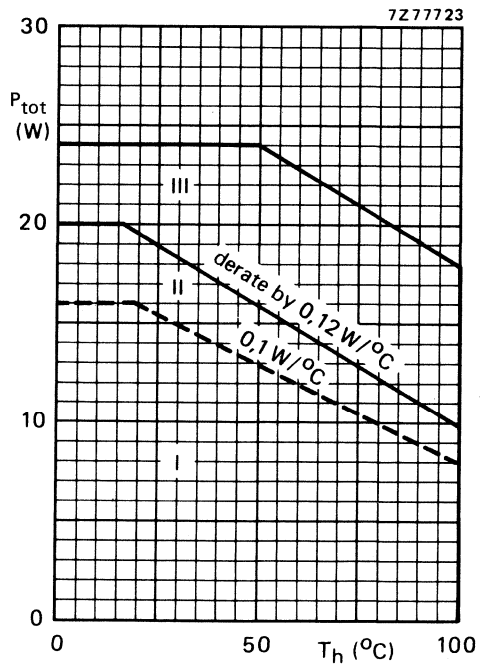


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 8 W;  $T_{mb} = 72,4$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th j-mb(dc)}$	=	10,7 K/W
From junction to mounting base (r.f. dissipation)	$R_{th j-mb(rf)}$	=	8,6 K/W
From mounting base to heatsink	$R_{th mb-h}$	=	0,3 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 2\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 10\text{ mA}$  $V_{(BR)CEO} > 36\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 1\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 36\text{ V}$  $I_{CES} < 1\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $ESBO > 0,5\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $ESBR > 0,5\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,4\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 50  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 1,25\text{ A}; I_B = 0,25\text{ A}$  $V_{CEsat}$  typ. 0,8 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 0,4\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 600 MHz $-I_E = 1,25\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 520 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_c$  typ. 10 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 50\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re}$  typ. 7,1 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

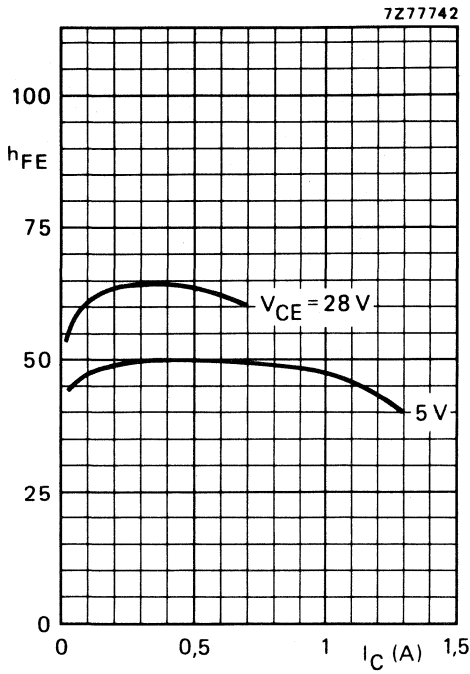


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

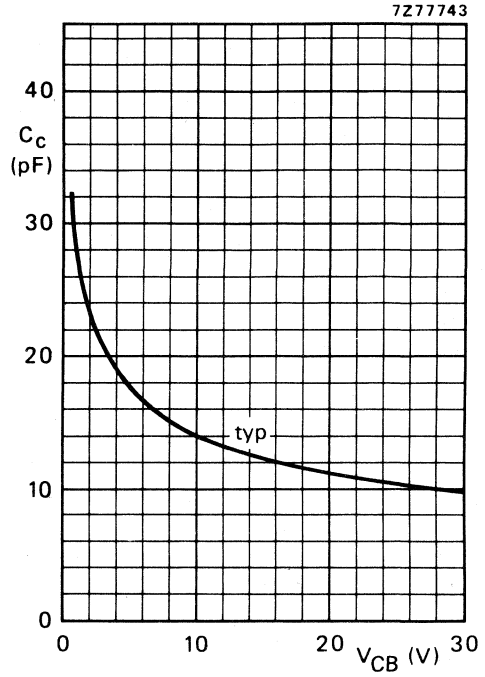


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

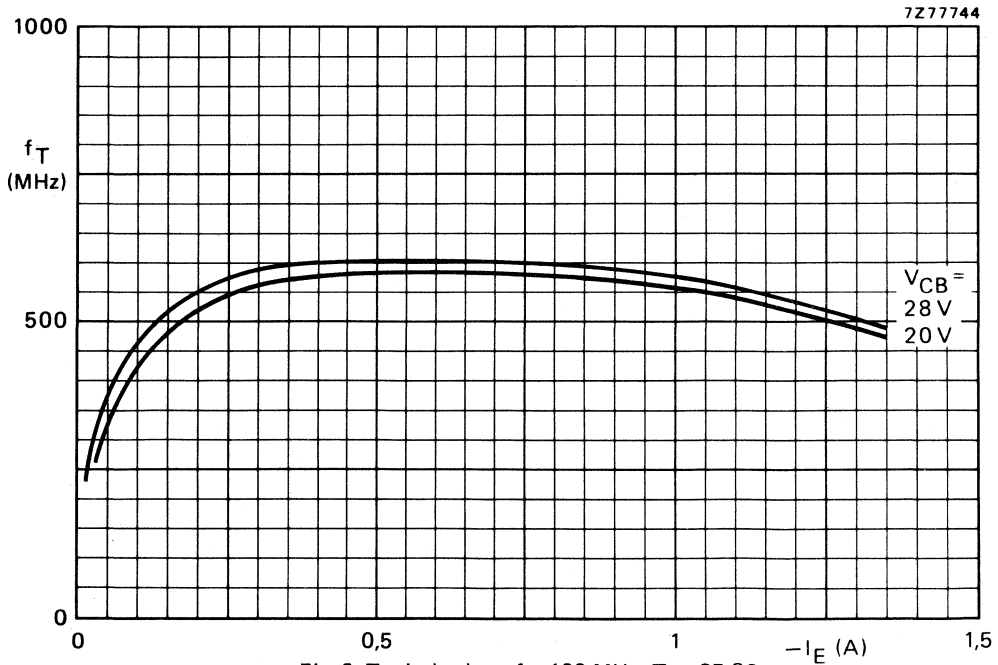


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	28	8	< 0,5	> 12	< 0,44	> 65	$1,8 + j0,7$	$18 - j20$

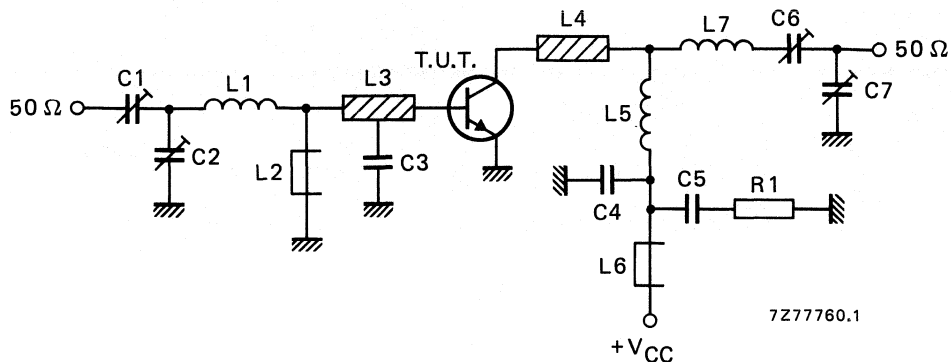


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = C7 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3 = 27 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

L1 = 1 turn Cu wire (1,6 mm); int. dia. 8,4 mm; leads 2 x 5 mm

L2 = 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

L6 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L7 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 8,2 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.

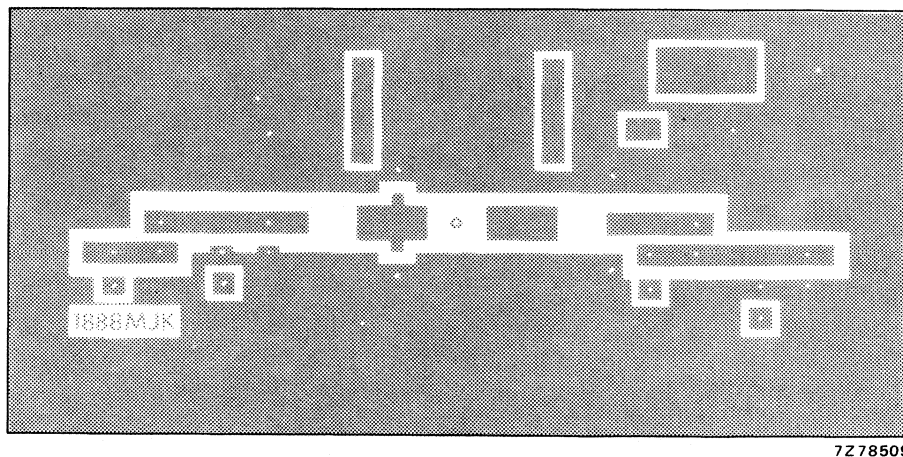
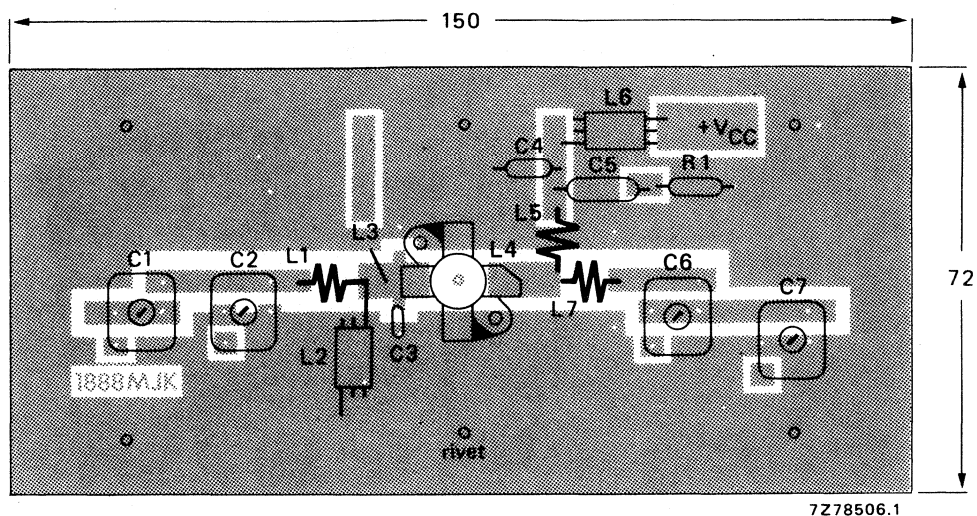


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

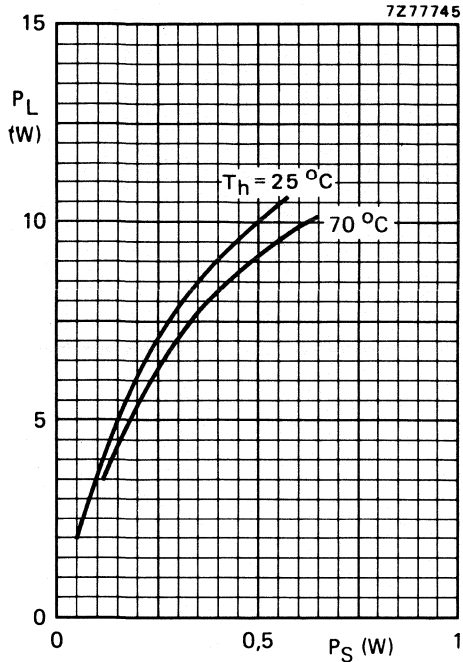


Fig. 9 Typical values;  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ .

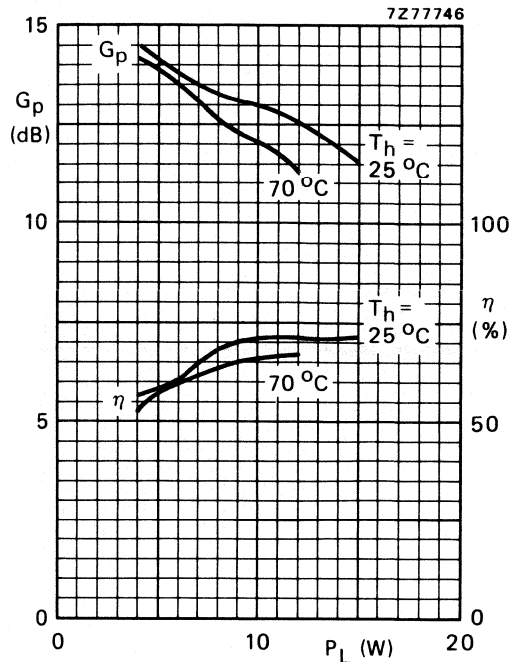


Fig. 10 Typical values;  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ .

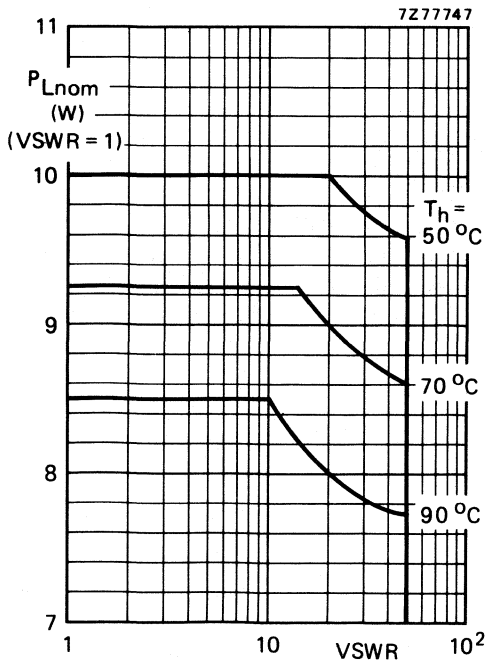


Fig. 11 R.F. SOAR; c.w. class-B operation;  $f = 175\text{ MHz}$ ;  $V_{CE} = 28\text{ V}$ ;  $R_{th\text{ mb-h}} = 0,3\text{ K/W}$ . The graph shows the permissible output power under nominal conditions (VSWR = 1) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

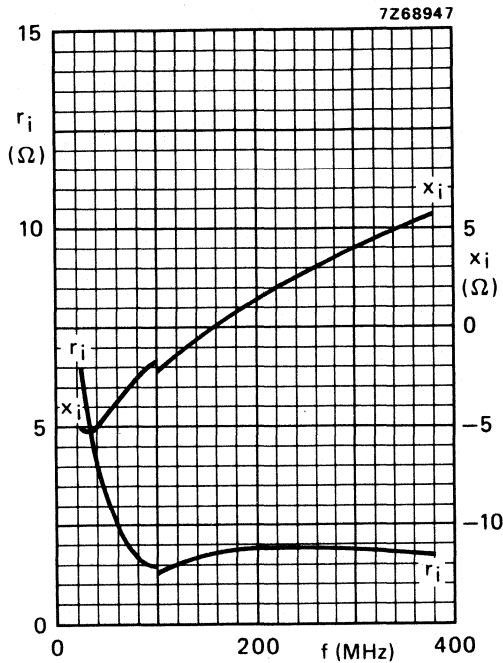


Fig. 12 Input impedance (series components).

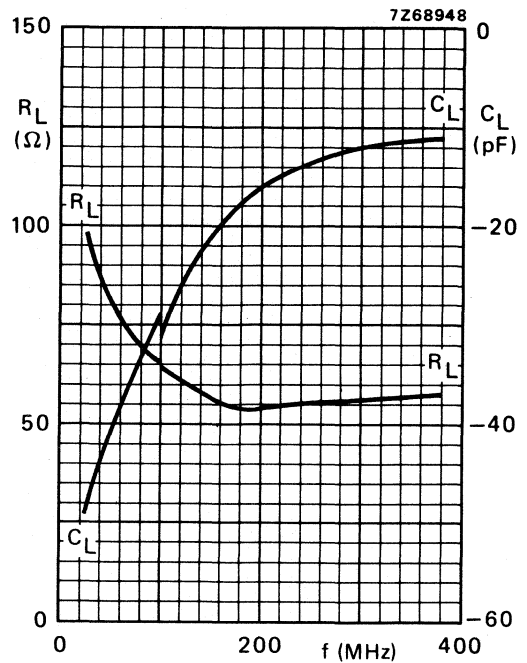


Fig. 13 Load impedance (parallel components).

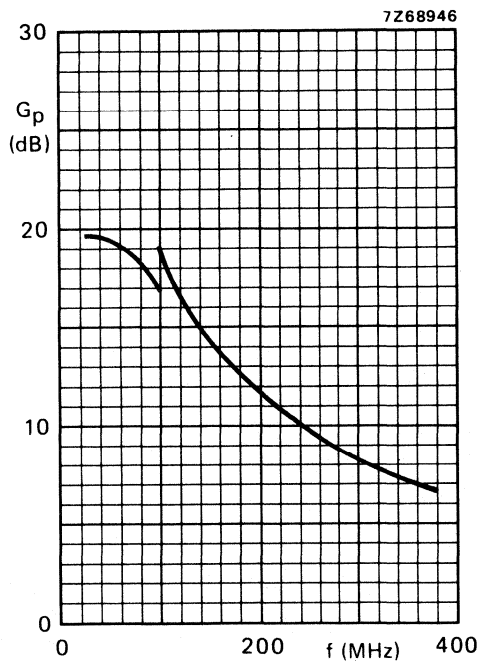


Fig. 14.

Conditions for Figs 12, 13 and 14.  
 Typical values;  $V_{CE} = 28$  V;  $P_L = 8$  W;  
 $T_h = 25$  °C.

**OPERATING NOTE**

Below 100 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation.  
 This resistor must be effective for r.f. only.



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated h.f. and v.h.f. transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

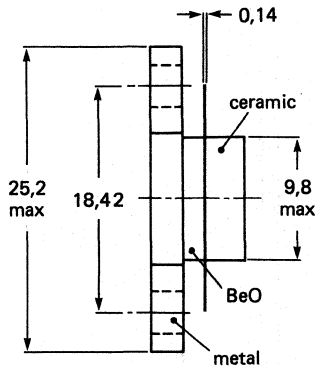
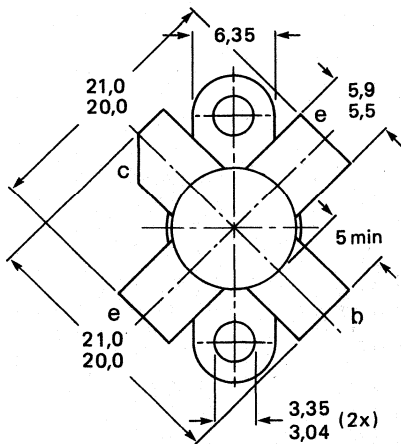
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	15	> 10	> 65	$1,4 + j1,85$	$33 - j27,5$

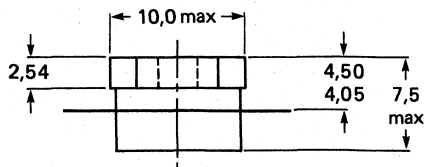
### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.



7Z77386.2



Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value

$V_{CESM}$  max. 65 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 36 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_{C(AV)}$  max. 1,75 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 5,0 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 36 W

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

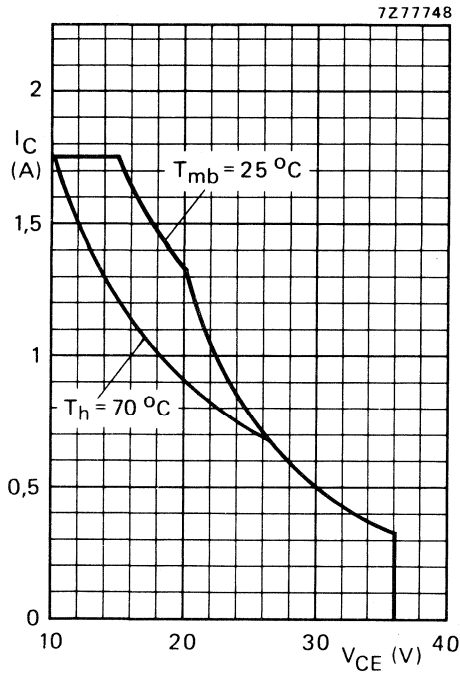


Fig. 2 D.C. SOAR.

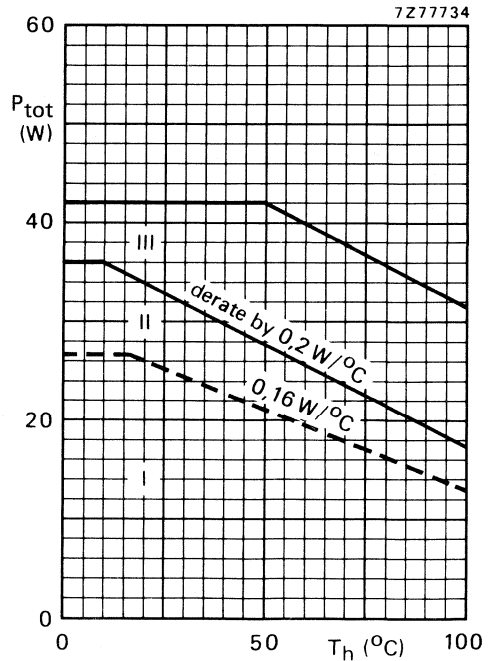


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 15 W;  $T_{mb} = 74,5$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th j-mb(dc)}$  = 6,55 K/W

From junction to mounting base (r.f. dissipation)

$R_{th j-mb(rf)}$  = 4,95 K/W

From mounting base to heatsink

$R_{th mb-h}$  = 0,3 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 5\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 25\text{ mA}$  $V_{(BR)CEO} > 36\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 2\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 36\text{ V}$  $I_{CES} < 2\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $ESBO > 2,5\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $ESBR > 2,5\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,7\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 50  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 2\text{ A}; I_B = 0,4\text{ A}$  $V_{CEsat}$  typ. 0,65 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 0,7\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 650 MHz $-I_E = 2\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 625 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_c$  typ. 18 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re}$  typ. 12,8 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

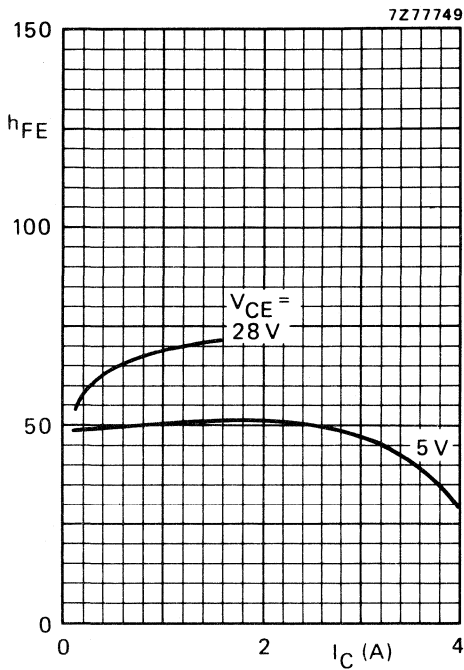


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

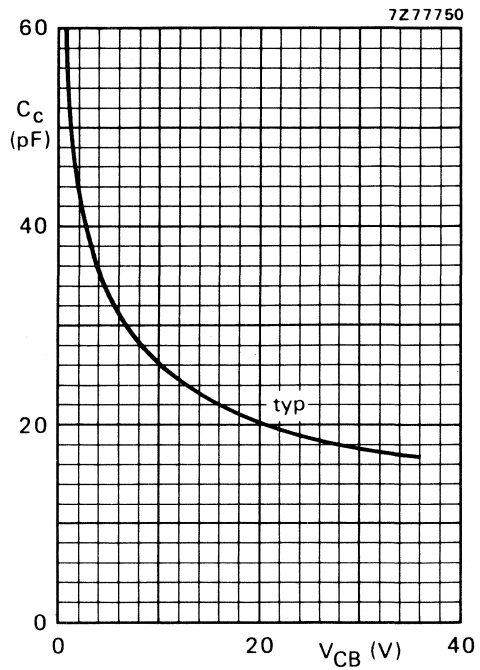


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

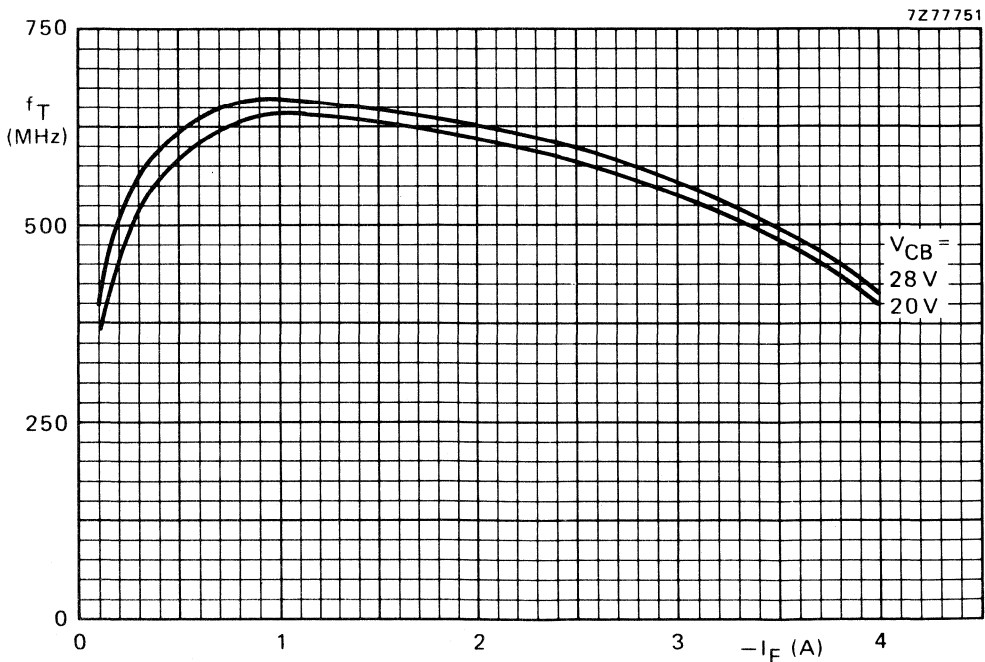


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	28	15	< 1,5	> 10	< 0,83	> 65	$1,4 + j1,85$	$33 - j27,5$

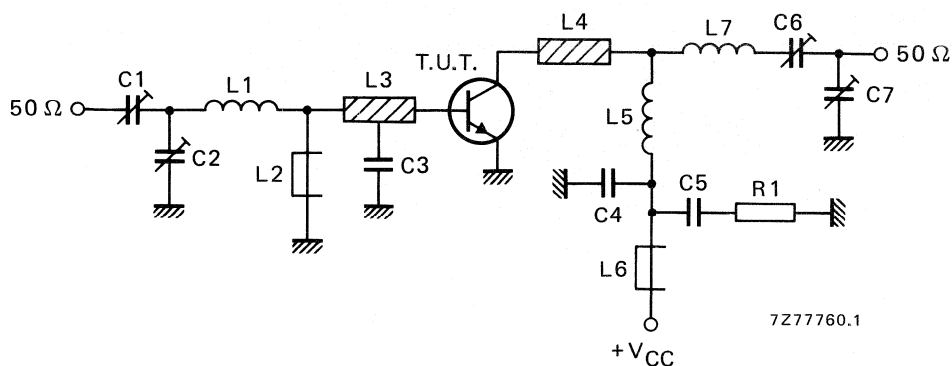


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = C7 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3 = 27 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

L1 = 1 turn Cu wire (1,6 mm); int. dia. 8,4 mm; leads 2 x 5 mm

L2 = 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

L6 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L7 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 8,2 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.

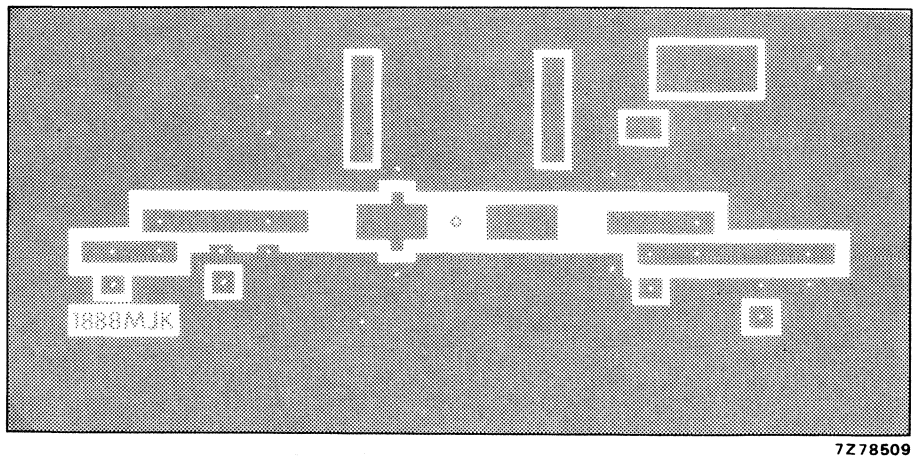
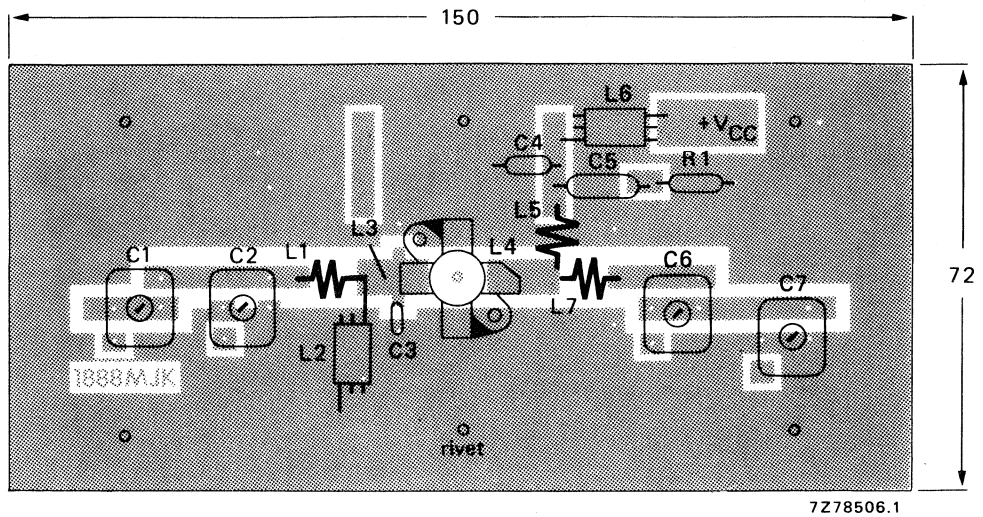


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

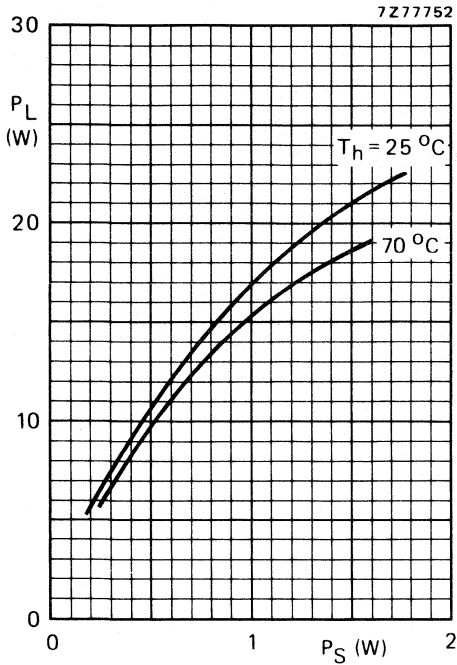


Fig. 9 Typical values;  $V_{CE} = 28 \text{ V}$ ;  $f = 175 \text{ MHz}$ .

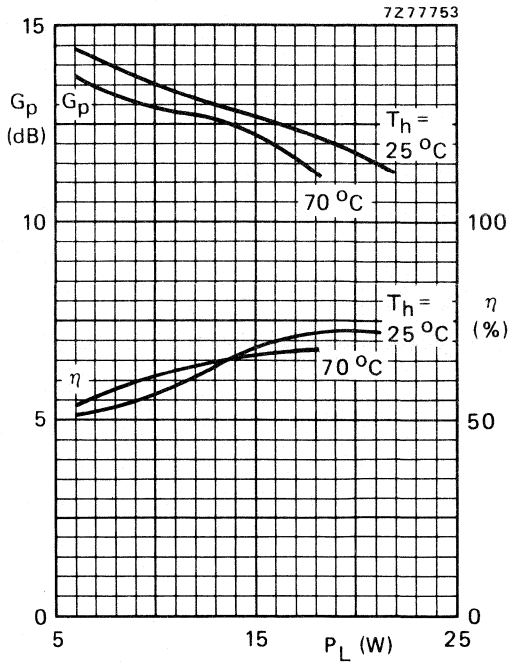


Fig. 10 Typical values;  $V_{CE} = 28 \text{ V}$ ;  $f = 175 \text{ MHz}$ .

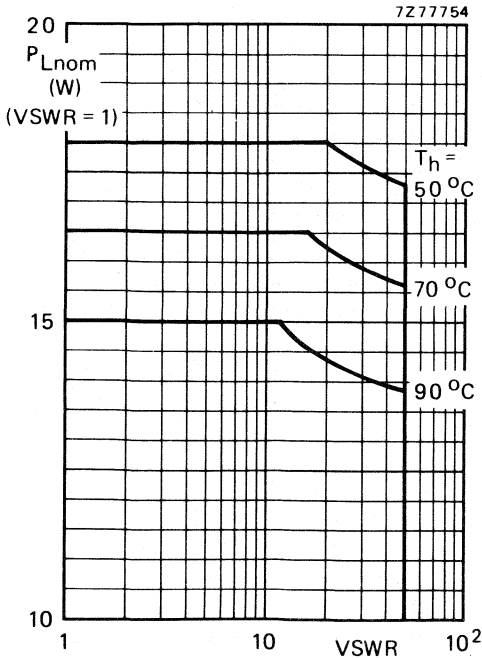


Fig. 11 R.F. SOAR; c.w. class-B operation;  $f = 175 \text{ MHz}$ ;  $V_{CE} = 28 \text{ V}$ ;  $R_{th \text{ mb-h}} = 0,3 \text{ K/W}$   
The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

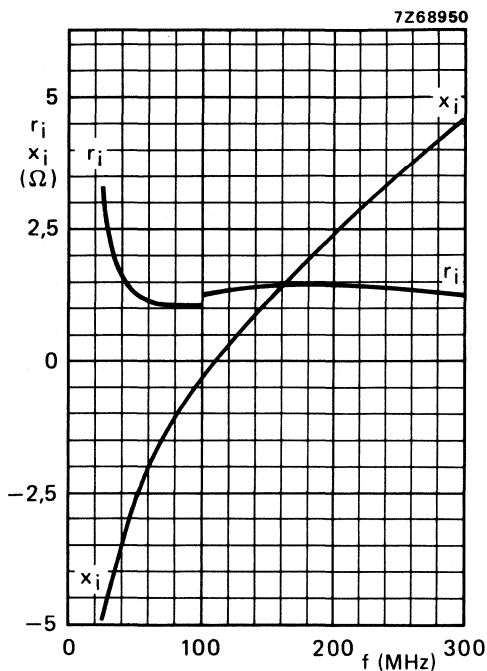


Fig. 12 Input impedance (series components).

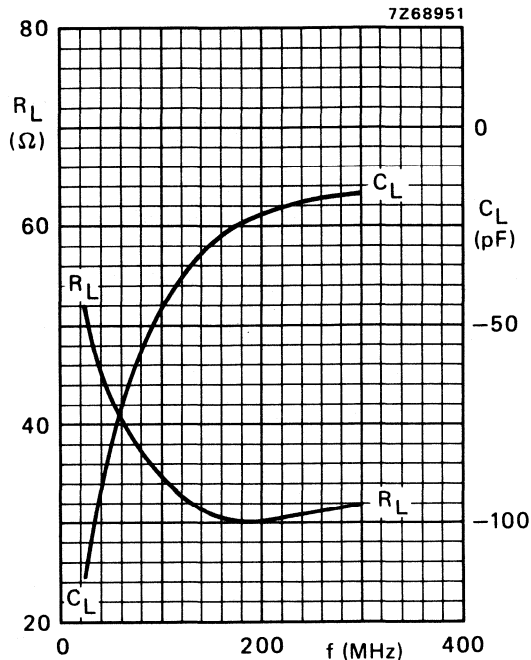


Fig. 13 Load impedance (parallel components).

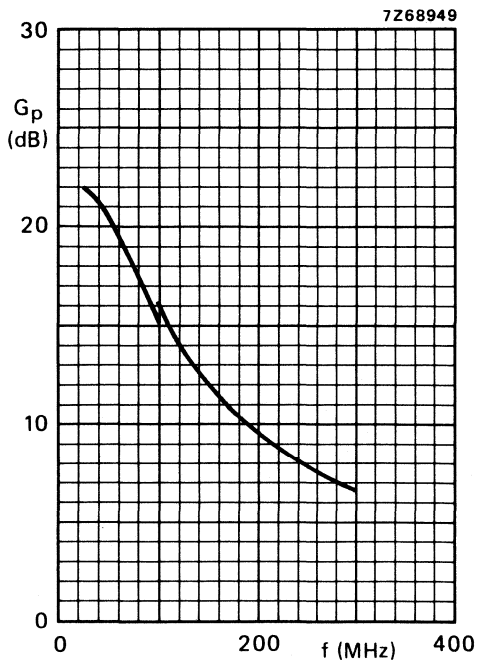


Fig. 14.

Conditions for Figs 12, 13 and 14.

Typical values;  $V_{CE} = 28$  V;  $P_L = 15$  W;

$T_h = 25$  °C.

**OPERATING NOTE**

Below 100 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation.

This resistor must be effective for r.f. only.



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily for use in v.h.f.-f.m. broadcast transmitters.

### Features:

- internally matched input for wideband operation and high power gain;
- multi-base structure and diffused emitter ballasting resistors for an optimum temperature profile;
- gold-metallization ensures excellent reliability.

The transistor has a 1/2in 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit.

mode operation	$V_{CE}$ V	f MHz	$P_L$ W	$P_S$ W	$G_p$ dB	$\eta$ %
narrow band; c.w.	28	108	175	< 17,5	> 10,0	> 65

### MECHANICAL DATA

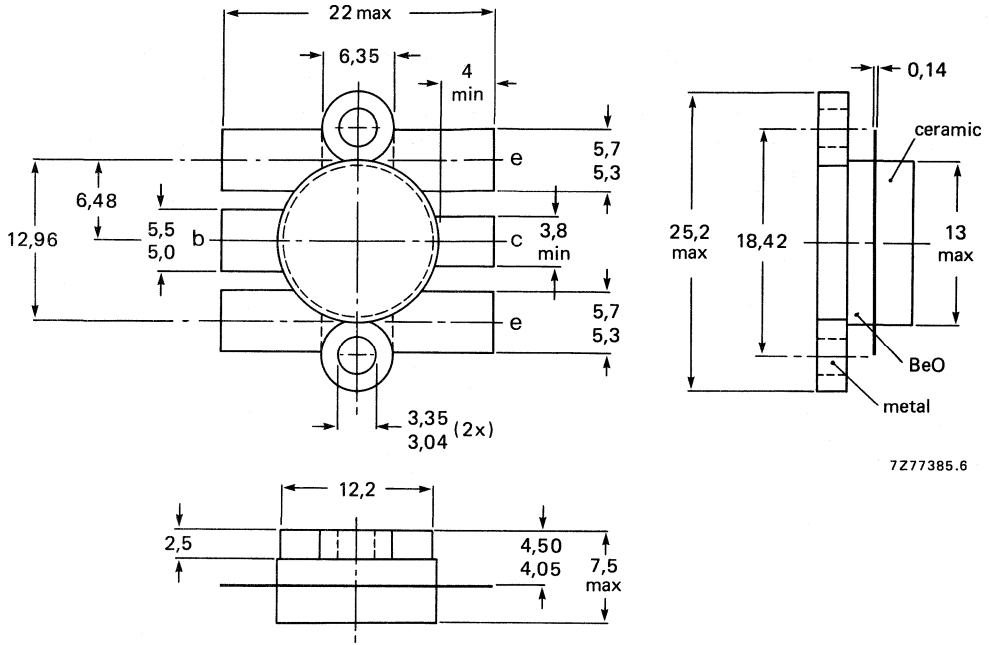
SOT-119 (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-119.



7Z77385.6

Torque on screw: min. 0,6 Nm (6 kg cm)  
 max. 0,75 Nm (7,5 kg cm)

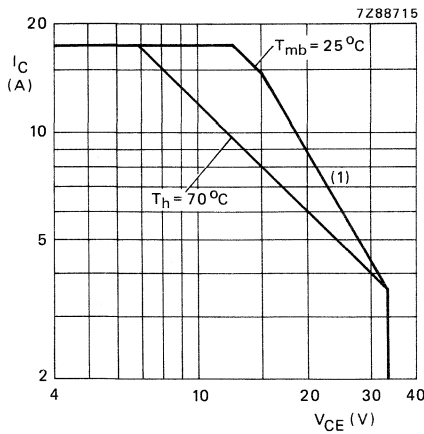
Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak value); $V_{BE} = 0$ open base	$V_{CESM}$	max.	65 V
Emitter-base voltage (open collector)	$V_{CEO}$	max.	33 V
Collector current d.c. or average (peak value); $f > 1$ MHz	$V_{EBO}$	max.	4 V
Total power dissipation at $T_{mb} = 25$ °C	$I_C; I_{C(AV)}$	max.	17,5 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$I_{CM}$	max.	35 A
R.F. power dissipation ( $f > 1$ MHz); $T_h = 70$ °C	$P_{tot}$ (d.c.)	max.	220 W
Storage temperature	$P_{tot}$ (r.f.)	max.	270 W
Operating junction temperature	$P_{tot}$ (r.f.)	max.	146 W
	$T_{stg}$		-65 to +150 °C
	$T_j$	max.	200 °C



(1) Second breakdown limit.

Fig. 2 D.C. SOAR.

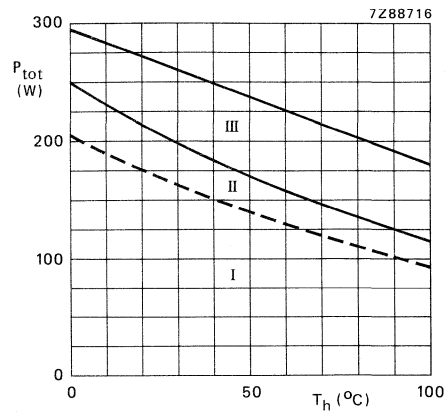


Fig. 3 Power derating curves vs. temperature.

- I Continuous d.c. operation
- II Continuous r.f. operation ( $f > 1$  MHz)
- III Short-time operation during mismatch; ( $f > 1$  MHz).

**THERMAL RESISTANCE** (dissipation = 150 W;  $T_{mb} = 72$  °C, i.e.  $T_h = 42$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th j-mb(dc)}$	max	0,85 K/W
From junction to mounting base (r.f. dissipation)	$R_{th j-mb(rf)}$	max	0,60 K/W
From mounting base to heatsink	$R_{th mb-h}$	max	0,2 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 50\text{ mA}$ open base;  $I_C = 200\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$  $V_{(BR)CEO} > 33\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 20\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 33\text{ V}$  $I_{CES} < 25\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 20\text{ mJ}$  $E_{SBR} > 20\text{ mJ}$  $R_{BE} = 10\ \Omega$ 

D.C. current gain\*

 $I_C = 8,5\text{ A}; V_{CE} = 25\text{ V}$  $h_{FE}$  typ. 50  
15 to 100

Collector-emitter saturation voltage\*

 $I_C = 20\text{ A}; I_B = 4,0\text{ A}$  $V_{CEsat}$  typ. 1,6 VTransition frequency at  $f = 100\text{ MHz}^{**}$  $-I_E = 8,5\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 600 MHz $-I_E = 20\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 600 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 25\text{ V}$  $C_C$  typ. 275 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 25\text{ V}$  $C_{re}$  typ. 155 pF

Collector-flange capacitance

 $C_{cf}$  typ. 3 pF\* Measured under pulse conditions:  $t_p \leq 300\ \mu\text{s}; \delta \leq 0,02$ .\*\* Measured under pulse conditions:  $t_p \leq 50\ \mu\text{s}; \delta \leq 0,01$ .

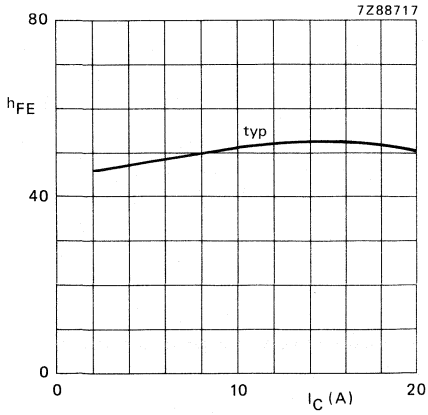


Fig. 4  $V_{CE} = 25$  V;  $T_j = 25$  °C.

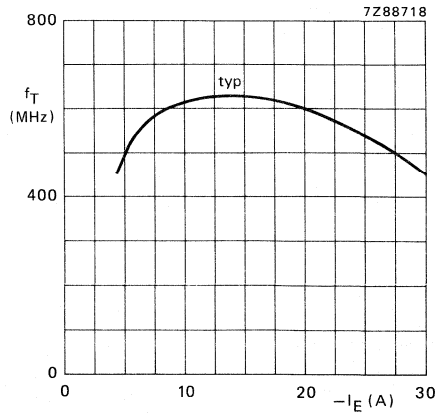


Fig. 5  $V_{CB} = 25$  V;  $f = 100$  MHz;  $T_j = 25$  °C.

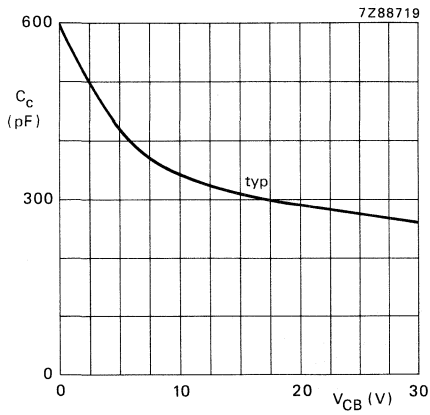
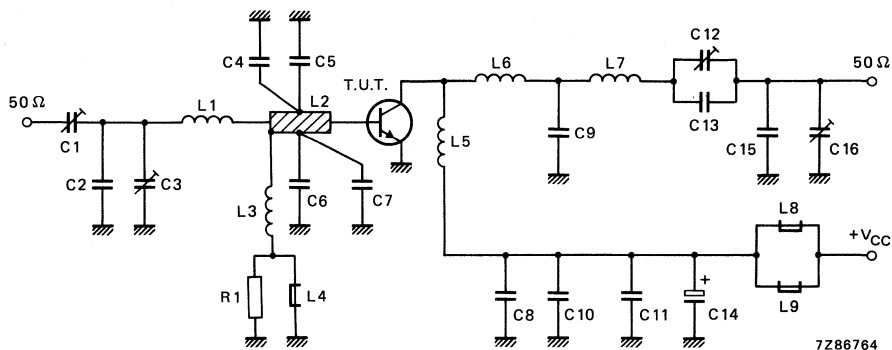


Fig. 6  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.

## APPLICATION INFORMATION

R.F. performance in narrow band c.w. operation (common-emitter class-B circuit)  $T_h = 25^\circ\text{C}$ 

f MHz	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	n %
108	28	175	< 17,5 typ. 13,9	> 10,0 typ. 11,0	< 9,6 typ. 8,9	> 65 typ. 70

Fig. 7 Class-B test circuit at  $f = 108$  MHz.

## List of components

C1 = C3 = 7 to 100 pF film dielectric trimmer (cat. no. 2222 809 07015)

C2 = C4 = C5 = C6 = C7 = 100 pF (500 V) multilayer ceramic chip capacitor (ATC<sup>▲</sup>); except for C2 these capacitors are placed 7 mm from transistor edge

C8 = C10 = 470 pF multilayer ceramic chip capacitor (cat. no. 2222 856 13471)

C9 = C15 = 40 pF, parallel connection of 4 x 10 pF lead feed-through capacitors (cat. no. 2222 702 05109)

C11 = 100 nF multilayer ceramic chip capacitor (cat. no. 2222 852 59104)

C12 = C16 = 7 to 47 pF precision tuning capacitor (cat. no. 2222 805 00174)

C13 = 19 pF, parallel connection of 4 x 4,7 pF lead feed-through capacitors (cat. no. 2222 702 04478)

C14 = 6,8  $\mu\text{F}/63$  V electrolytic capacitor

L1 = Cu strip (10 mm x 4 mm x 0,5 mm)

L2 = strip on printed-circuit board

L3 = 7 turns closely wound enamelled Cu wire (0,3 mm); int. dia. 3,0 mm; leads 2 x 6 mm

L4 = L8 = L9 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L5 = 3 turns enamelled Cu wire (1,6 mm); int. dia. 8 mm; length 9 mm; leads 2 x 5 mm

L6 = Cu strip (27 mm x 9 mm x 0,5 mm)

L7 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 8 mm; length 9 mm; leads 2 x 10 mm

L2 is strip on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16 in.

R1 = 10  $\Omega$  carbon resistor<sup>▲</sup> ATC means American Technical Ceramics.

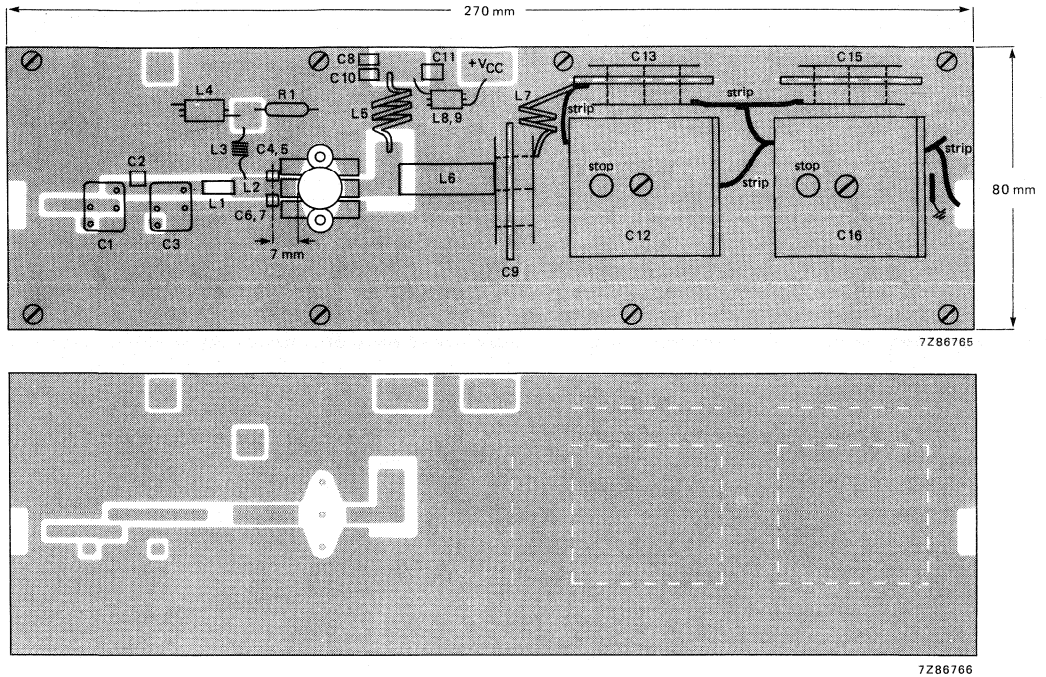


Fig. 8 Component layout and printed-circuit board for 108 MHz class-B test circuit. (Dimensions in mm.)

The circuit and the components are on one side of the epoxy fibre-glass board, the other side is unetched copper to serve as a ground-plane. Earth connections are made by means of fixing screws. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.

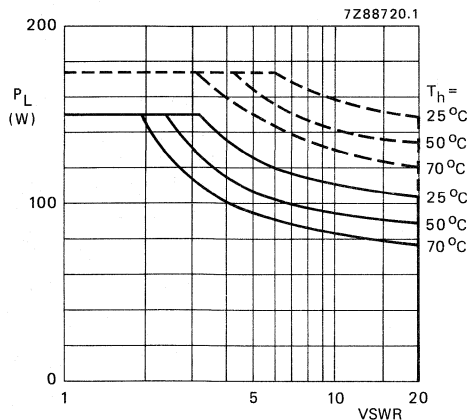


Fig. 9 R.F. SOAR. —  $f > 1$  MHz (continuous);  
 - - - short time operation during mismatch ( $f > 1$  MHz).

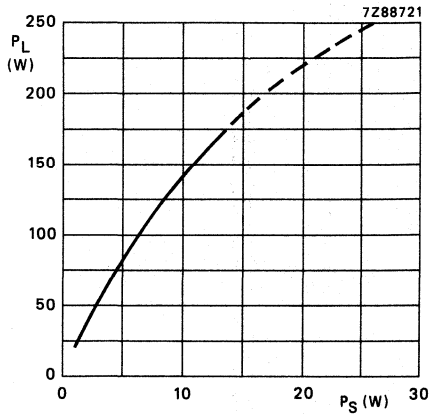


Fig. 10 Load power as a function of source power.

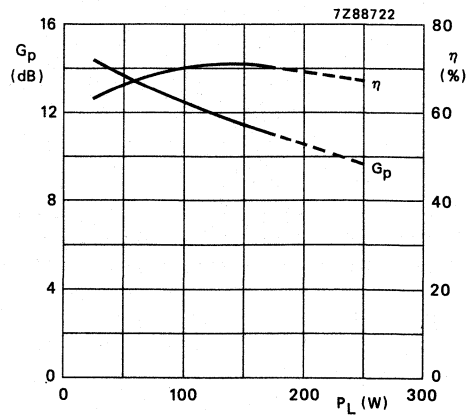


Fig. 11 Power gain and efficiency as a function of source power.

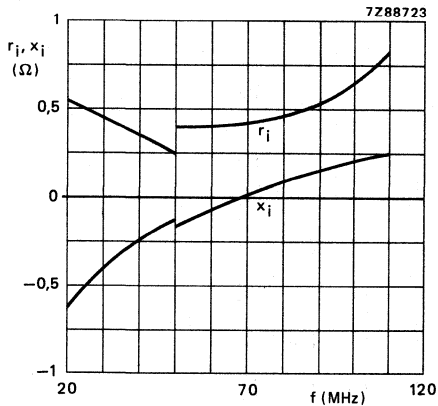


Fig. 12 Input impedance (series components).

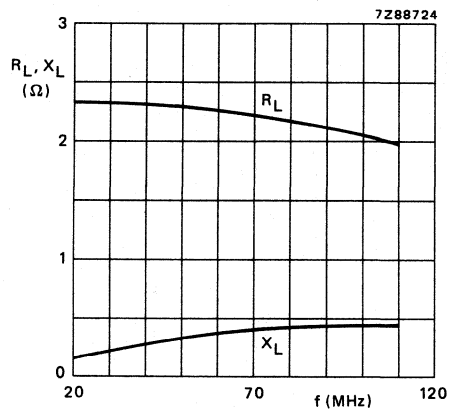


Fig. 13 Load impedance (series components).

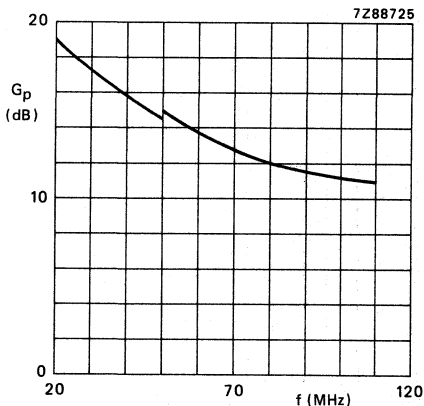


Fig. 14 Power gain as a function of frequency.

Conditions for Figs 10 and 11:

Test circuit tuned for each power level;  
 typical values;  $V_{CE} = 28 \text{ V}$ ;  $f = 108 \text{ MHz}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 28 \text{ V}$ ;  $P_L = 175 \text{ W}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation.

**OPERATING NOTE** for Figs 12, 13 and 14:

Below 50 MHz a base-emitter resistor of  $4,7 \text{ } \Omega$  is recommended to avoid oscillation.

This resistor must be effective for r.f. only.



## V.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in linear v.h.f. amplifiers for television transmitters and transposers. Diffused emitter ballasting resistors and the application of **gold sandwich metallization** ensure an optimum temperature profile and excellent reliability properties.

The transistor has a ¼" capstan envelope with ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

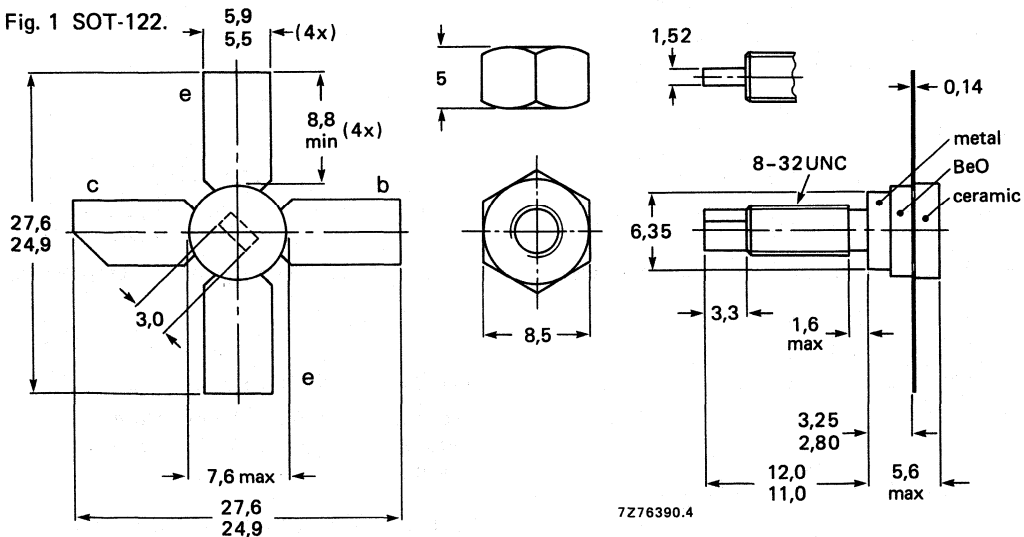
R.F. performance mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ A	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{O sync}}^*$ W	$G_{\text{p}}$ dB
class-A; linear amplifier	224,25 224,25	25 25	0,46 0,46	70 25	-60 -60	> 1,5 typ. 1,7	> 18 typ. 20

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage

(peak value);  $V_{BE} = 0$

open base

$V_{CESM}$  max. 60 V

$V_{CEO}$  max. 30 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current

d.c. or average

$I_C; I_{C(AV)}$  max. 1,5 A

(peak value);  $f > 1$  MHz

$I_{CM}$  max. 3,5 A

Total power dissipation at  $T_{mb} = 25$  °C

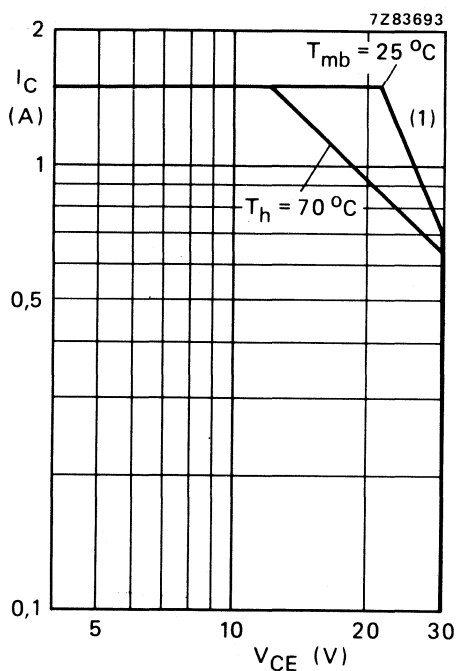
$P_{tot}$  max. 32,5 W

Storage temperature

$T_{stg}$  -65 to +150 °C

Operating junction temperature

$T_j$  max. 200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

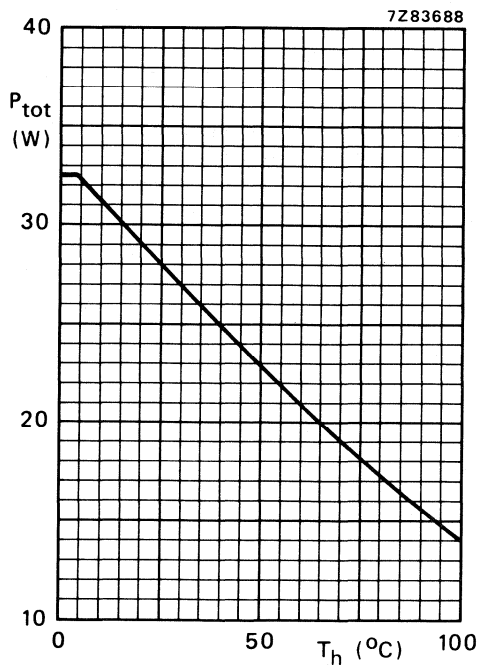


Fig. 3 Power derating curve vs. temperature.

**THERMAL RESISTANCE** (see Fig. 4)

From junction to mounting base

(dissipation = 12 W;  $T_{mb} = 77$  °C; i.e.  $T_h = 70$  °C)

$R_{th j-mb} = 5,6$  K/W

From mounting base to heatsink

$R_{th mb-h} = 0,6$  K/W

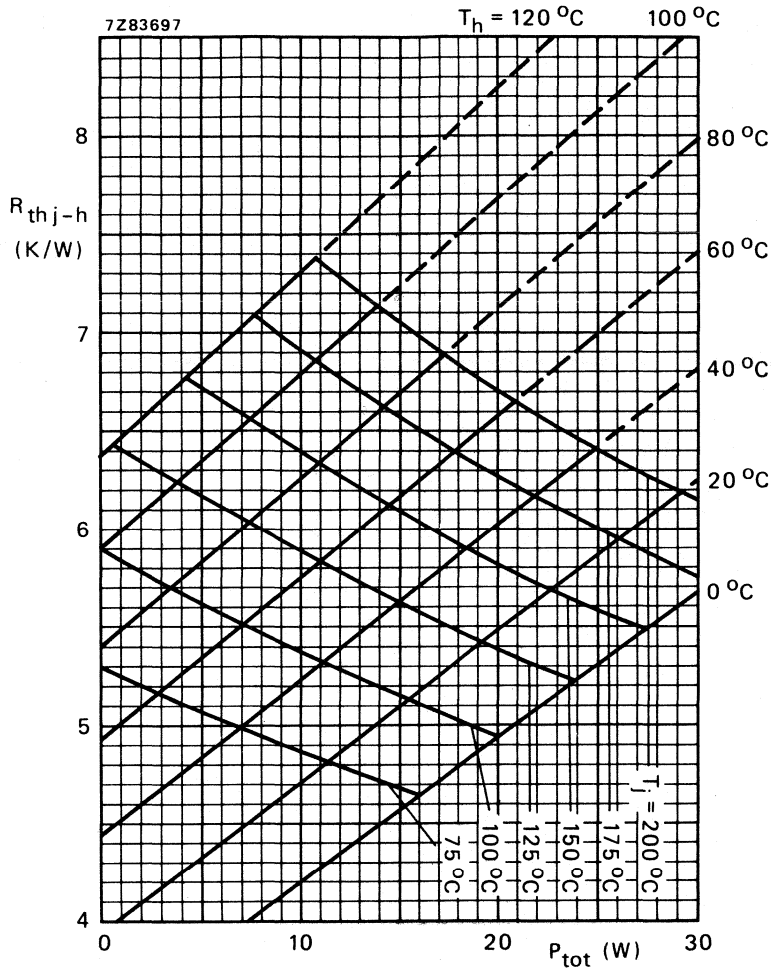


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,6\text{ K/W}$ ).

#### Example

Nominal class-A operation;  $V_{CE} = 25\text{ V}$ ;  $I_C = 0,46\text{ A}$ ;  $T_h = 70\text{ }^\circ\text{C}$ .

Fig. 4 shows:  $R_{th\ j-h}$  max.  $6,13\text{ K/W}$   
 $T_j$  max.  $140,5\text{ }^\circ\text{C}$

Typical device:  $R_{th\ j-h}$  typ.  $5,45\text{ K/W}$   
 $T_j$  typ.  $133\text{ }^\circ\text{C}$

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 60\text{ V}$ open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 30\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 4\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 30\text{ V}$  $I_{CES} < 4\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $ESBO > 2\text{ mJ}$  $R_{BE} = 10\ \Omega$  $ESBR > 2\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,5\text{ A}; V_{CE} = 25\text{ V}$  $h_{FE}$  typ. 65  
15 to 120

Collector-emitter saturation voltage \*

 $I_C = 1,0\text{ A}; I_B = 0,1\text{ A}$  $V_{CEsat}$  typ. 0,8 VTransition frequency at  $f = 500\text{ MHz}$  \*\* $-I_E = 0,5\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 1,20 GHz $-I_E = 1,0\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 1,15 GHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 25\text{ V}$  $C_c$  typ. 18 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 20\text{ mA}; V_{CE} = 25\text{ V}$  $C_{re}$  typ. 9,2 pF

Collector-stud capacitance

 $C_{cs}$  typ. 1,2 pF\* Measured under pulse conditions:  $t_p \leq 300\ \mu\text{s}; \delta \leq 0,02$ .\*\* Measured under pulse conditions:  $t_p \leq 50\ \mu\text{s}; \delta \leq 0,01$ .

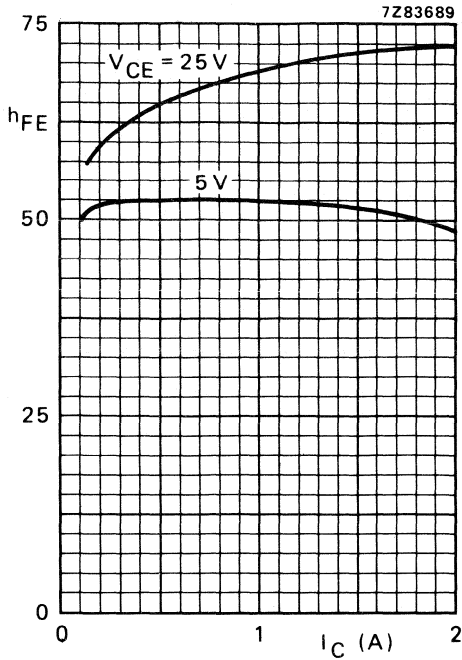


Fig. 5 Typical values;  $T_j = 25^\circ\text{C}$ .

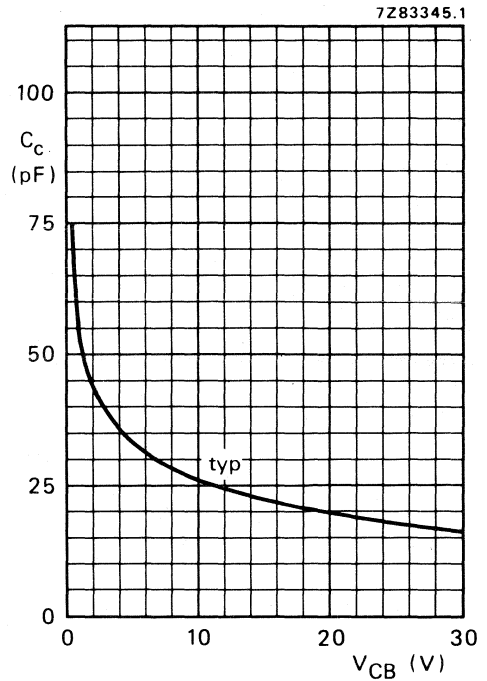


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

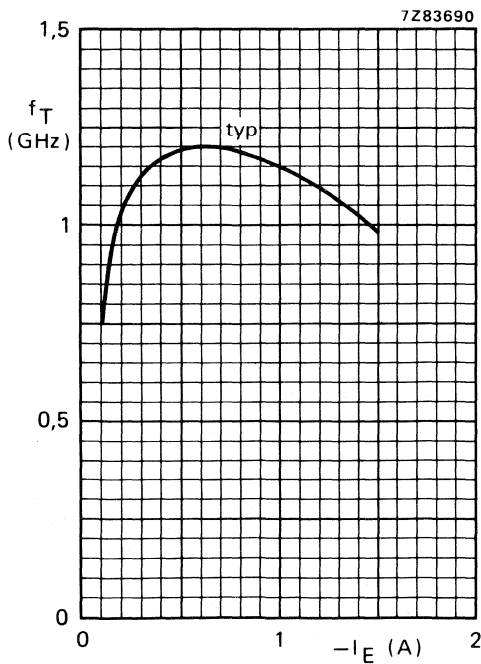


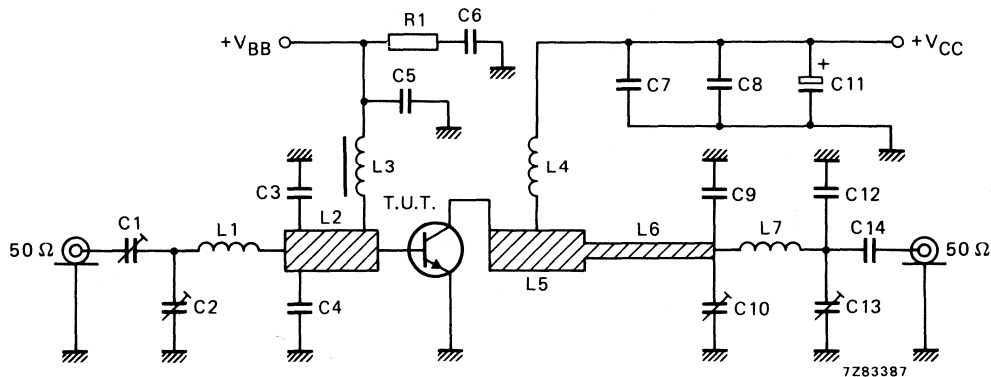
Fig. 7  $V_{CB} = 25\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in v.h.f. class-A operation (linear power amplifier)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (A)	$T_{\text{h}}$ ( $^{\circ}\text{C}$ )	$d_{\text{im}}$ (dB) *	$P_{\text{O sync}}$ (W) *	$G_{\text{p}}$ (dB)
224,25	25	0,46	70	-60	> 1,5	> 18
224,25	25	0,46	70	-60	typ. 1,7	typ. 19,5
224,25	25	0,46	25	-60	typ. 1,8	typ. 20

\* Three-tone test method (vision carrier  $-8$  dB, sound carrier  $-7$  dB, sideband signal  $-16$  dB), zero dB corresponds to peak sync level.

Fig. 8 Test circuit at  $f_{\text{vision}} = 224,25$  MHz.

## List of components:

- C1 = 1,8 to 10 pF film dielectric trimmer (cat. no. 2222 809 05002)
- C2 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)
- C3 = C4 = 82 pF multilayer ceramic chip capacitor (ATC<sup>▲</sup>), placed 7 mm from transistor edge
- C5 = C7 = C14 = 680 pF (50 V) multilayer ceramic chip capacitor (cat. no. 2222 852 13681)
- C6 = C8 = 330 nF polyester capacitor
- C9 = 43 pF (500 V) multilayer ceramic chip capacitor (ATC<sup>▲</sup>)
- C10 = C13 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)
- C11 = 10  $\mu\text{F}/40$  V solid aluminium electrolytic capacitor
- C12 = 18 pF (500 V) multilayer ceramic chip capacitor (ATC<sup>▲</sup>)
- L1 = 49 nH; 4 turns enamelled Cu wire (1,0 mm); int. dia. 3,6 mm; length 6,3 mm; leads 2 x 5 mm
- L2 = L5 = 30  $\Omega$  stripline (10,0 mm x 6,0 mm)
- L3 = 0,1  $\mu\text{H}$ ; microchoke (cat. no. 4322 057 01070)
- L4 = 130 nH; 6 turns enamelled Cu wire (1,0 mm); int. dia. 6,0 mm; length 10,7 mm; leads 2 x 5 mm
- L6 = 60  $\Omega$  stripline (50,5 mm x 2,0 mm)
- L7 = 30 nH; 4 turns enamelled Cu wire (1,0 mm); int. dia. 3,0 mm; length 7,9 mm; leads 2 x 5 mm
- L2, L5 and L6 are striplines on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric ( $\epsilon_r \approx 4,5$ ); thickness 1/16".
- R1 = 10  $\Omega$  carbon resistor

<sup>▲</sup> ATC means American Technical Ceramics.

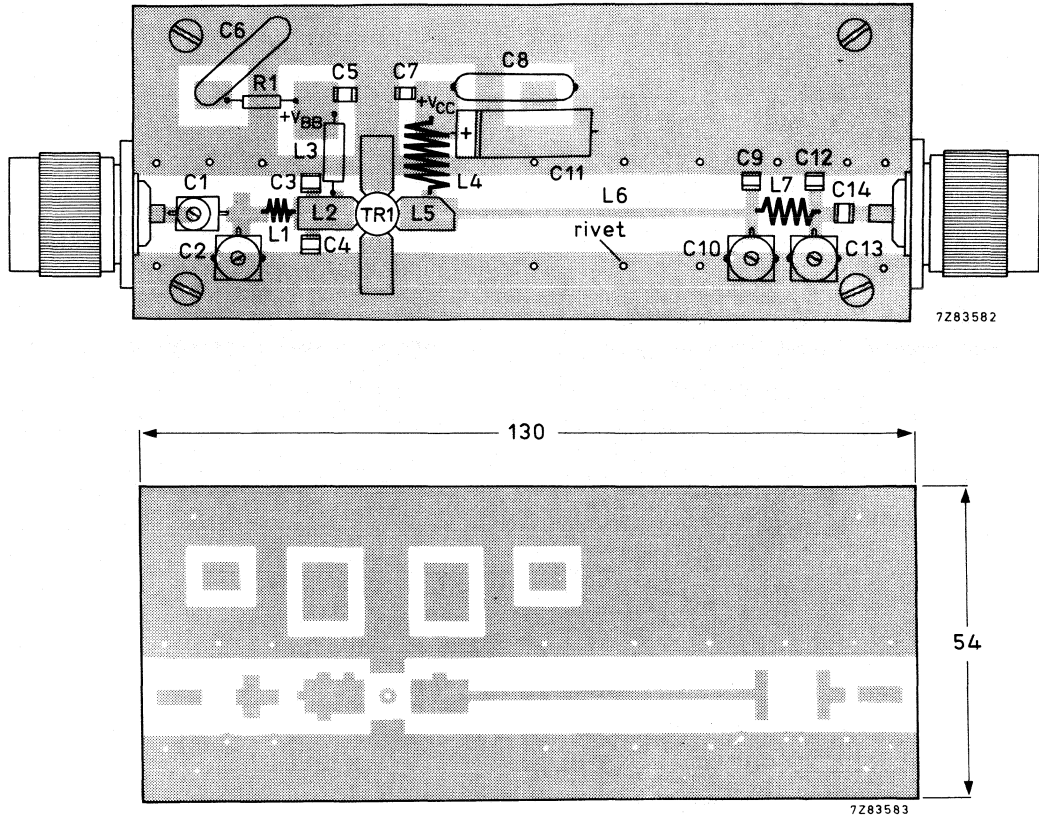


Fig. 9 Component layout and printed-circuit board for 224,25 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

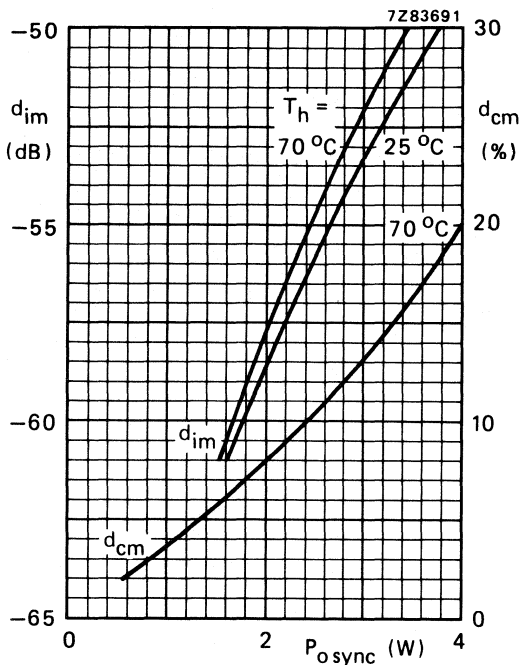


Fig. 10 Intermodulation distortion ( $d_{im}^*$ ) and cross-modulation distortion ( $d_{cm}^{**}$ ) as a function of output power.

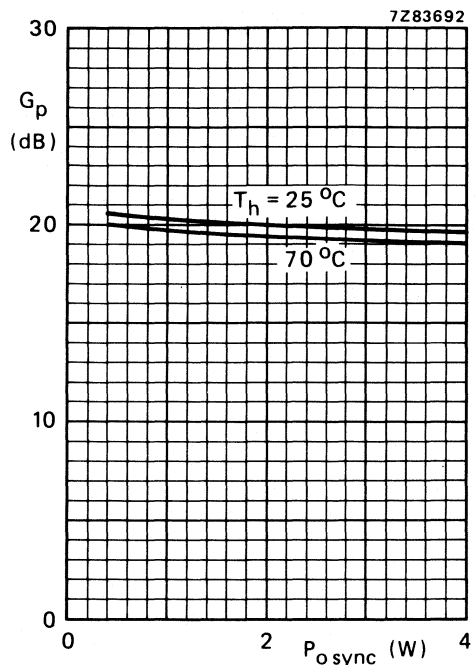


Fig. 11 Power gain as a function of output power.

Conditions for Figs 10 and 11:

Typical values;  $V_{CE} = 25\text{ V}$ ;  $I_C = 0,46\text{ A}$ ;  $f_{vision} = 224,25\text{ MHz}$ .

\* Three-tone test method (vision carrier  $-8\text{ dB}$ , sound carrier  $-7\text{ dB}$ , sideband signal  $-16\text{ dB}$ ), zero dB corresponds to peak sync level.

Intermodulation distortion of input signal  $\leq -75\text{ dB}$ .

\*\* Two-tone test method (vision carrier  $0\text{ dB}$ , sound carrier  $-7\text{ dB}$ ), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from  $0\text{ dB}$  to  $-20\text{ dB}$ .



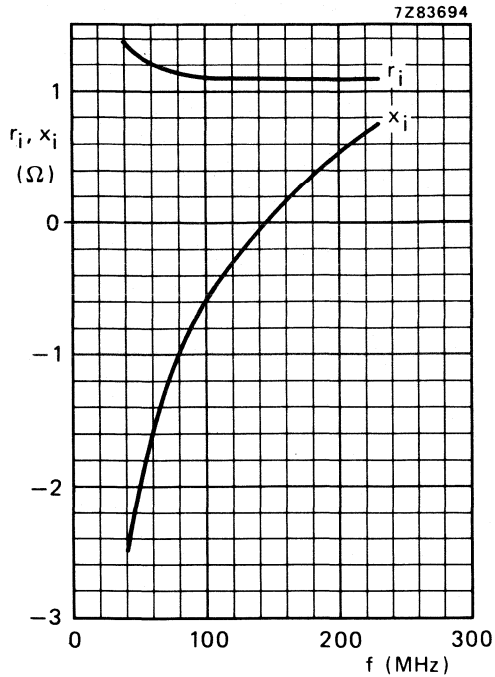


Fig. 12 Input impedance (series components).

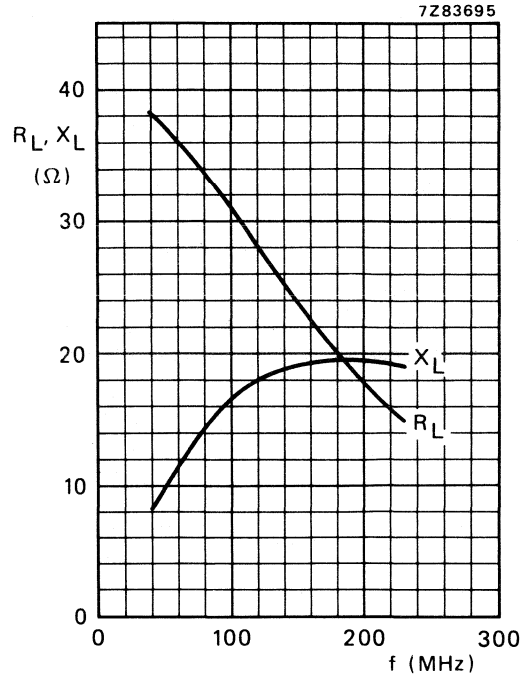


Fig. 13 Load impedance (series components).

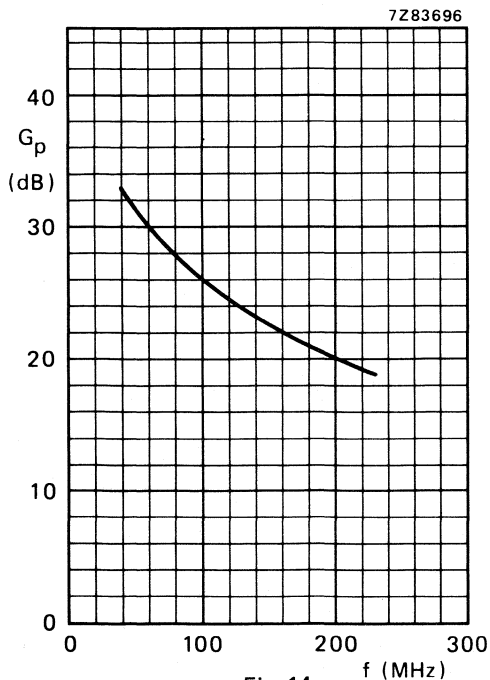


Fig. 14.

Conditions for Figs 12, 13 and 14:  
 Typical values;  $V_{CE} = 25$  V;  $I_C = 0,46$  A;  
 $T_h = 70$  °C.



## V.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in linear v.h.f. amplifiers for television transmitters and transposers. Diffused emitter ballasting resistors and the application of **gold sandwich metallization** ensure an optimum temperature profile and excellent reliability properties. The transistor has a 1/4" capstan envelope with ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

R.F. performance

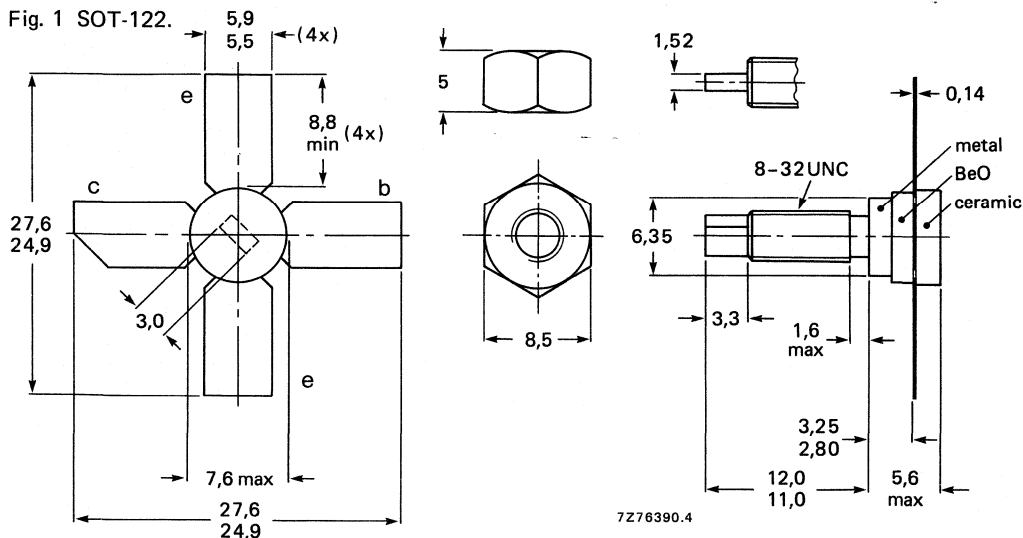
mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ A	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{O sync}}^*$ W	$G_{\text{p}}$ dB
class-A; linear amplifier	224,25 224,25	25 25	0,8 0,8	70 25	-58 -58	> 5 typ. 7	> 15 typ. 16,5

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage  
(peak value);  $V_{BE} = 0$

$V_{CESM}$  max. 60 V

open base

$V_{CEO}$  max. 30 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current

d.c. or average

$I_C; I_C(AV)$  max. 3 A

(peak value);  $f > 1$  MHz

$I_{CM}$  max. 6 A

Total power dissipation at  $T_{mb} = 25$  °C

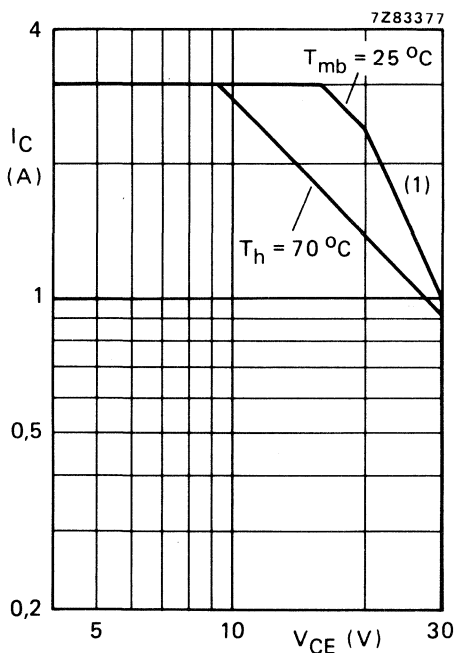
$P_{tot}$  max. 48 W

Storage temperature

$T_{stg}$  -65 to +150 °C

Operating junction temperature

$T_j$  max. 200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

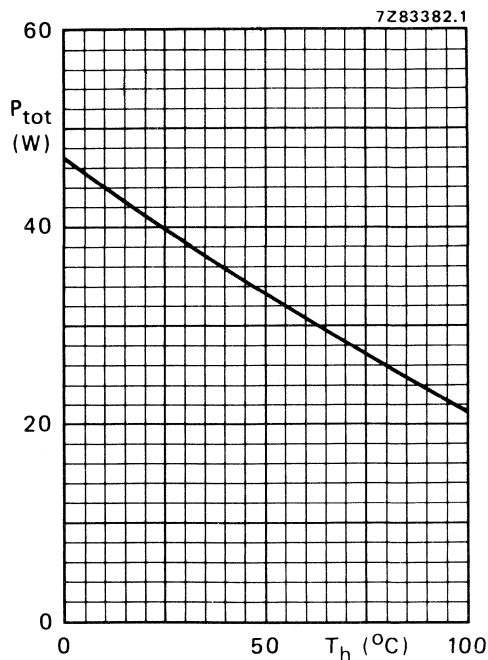


Fig. 3 Power derating curve vs. temperature.

**THERMAL RESISTANCE** (see Fig. 4)

From junction to mounting base

(dissipation = 20 W;  $T_{mb} = 82$  °C; i.e.  $T_h = 70$  °C)

$R_{th\ j-mb}$  = 3,45 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,6 K/W

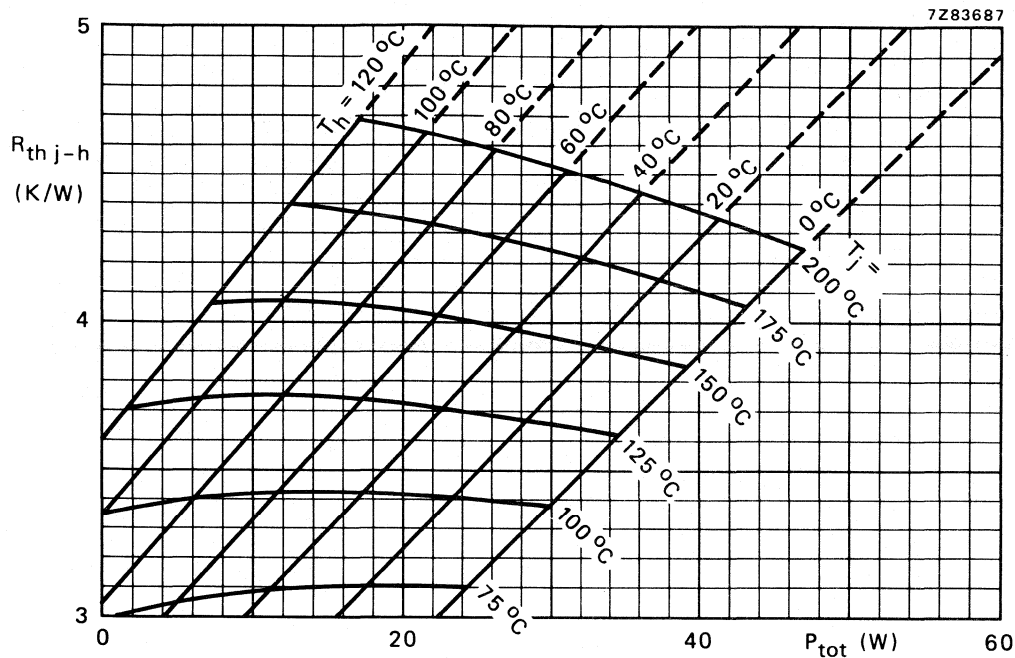


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,6\text{ K/W.}$ )

#### Example

Nominal class-A operation:  $V_{CE} = 25\text{ V}$ ;  $I_C = 0,8\text{ A}$ ;  $T_h = 70\text{ °C}$ .

Fig. 4 shows:  $R_{th\ j-h}$  max. 4,05 K/W  
 $T_j$  max. 151 °C

Typical device:  $R_{th\ j-h}$  typ. 3,80 K/W  
 $T_j$  typ. 146 °C

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 25\text{ mA}$

open base;  $I_C = 100\text{ mA}$

$V_{(BR)CES} > 60\text{ V}$

$V_{(BR)CEO} > 30\text{ V}$

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0; V_{CE} = 30\text{ V}$

$I_{CES} < 10\text{ mA}$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$

open base

$E_{SBO} > 3\text{ mJ}$

$R_{BE} = 10\ \Omega$

$E_{SBR} > 3\text{ mJ}$

D.C. current gain \*

$I_C = 0,8\text{ A}; V_{CE} = 25\text{ V}$

$h_{FE}$  typ. 75  
15 to 120

Collector-emitter saturation voltage \*

$I_C = 2,0\text{ A}; I_B = 0,2\text{ A}$

$V_{CEsat}$  typ. 1,0 V

Transition frequency at  $f = 500\text{ MHz}$  \*\*

$-I_E = 0,8\text{ A}; V_{CB} = 25\text{ V}$

$f_T$  typ. 1,0 GHz

$-I_E = 2,0\text{ A}; V_{CB} = 25\text{ V}$

$f_T$  typ. 1,1 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 25\text{ V}$

$C_C$  typ. 35 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 100\text{ mA}; V_{CE} = 25\text{ V}$

$C_{re}$  typ. 20 pF

Collector-stud capacitance

$C_{cs}$  typ. 1,2 pF

\* Measured under pulse conditions:  $t_p \leq 300\ \mu\text{s}; \delta \leq 0,02$ .

\*\* Measured under pulse conditions:  $t_p \leq 50\ \mu\text{s}; \delta \leq 0,01$ .

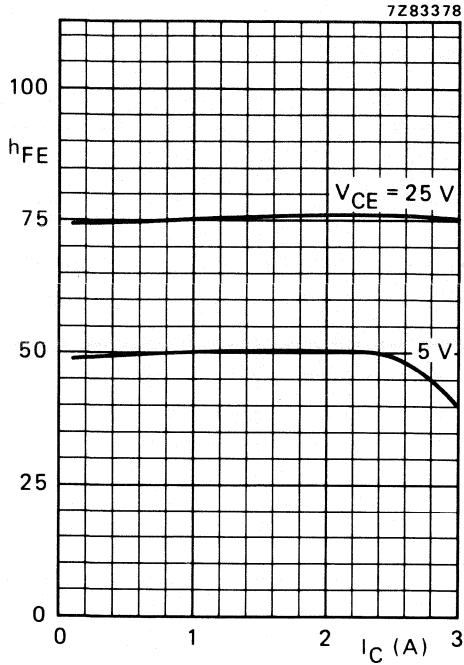


Fig. 5 Typical values;  $T_j = 25$  °C.

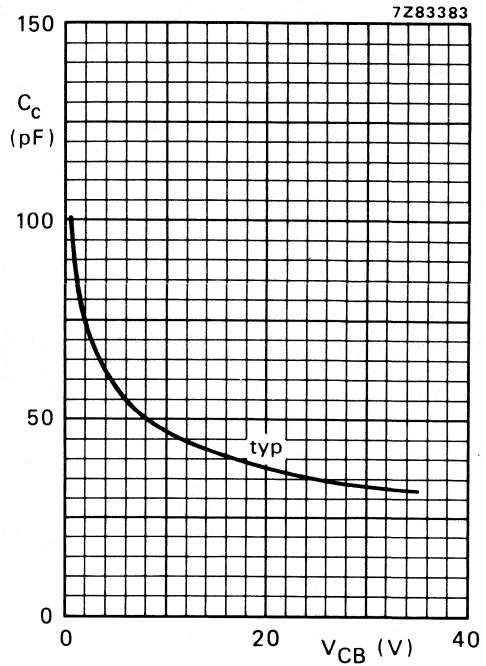


Fig. 6  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.

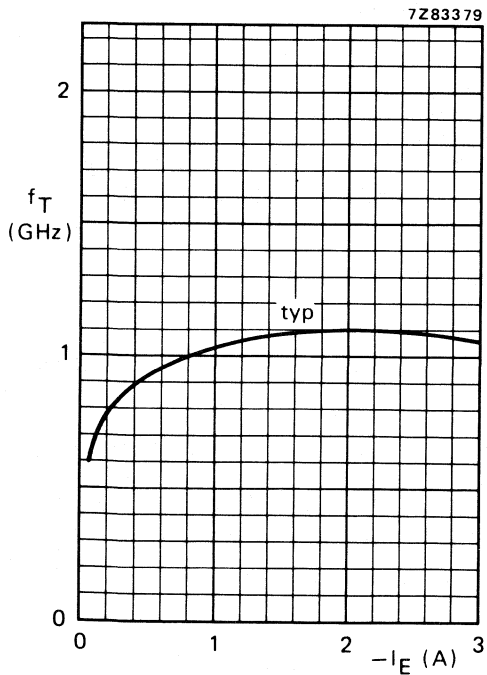


Fig. 7  $V_{CB} = 25$  V;  $f = 500$  MHz;  $T_j = 25$  °C.

## APPLICATION INFORMATION

R.F. performance in v.h.f. class-A operation (linear power amplifier)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (A)	$T_{\text{h}}$ ( $^{\circ}\text{C}$ )	$d_{\text{im}}$ (dB)*	$P_{\text{O sync}}$ (W)*	$G_{\text{p}}$ (dB)
224,25	25	0,8	70	-58	> 5	> 15
224,25	25	0,8	70	-58	typ. 5,8	typ. 16,2
224,25	25	0,8	25	-58	typ. 7	typ. 16,5

\* Three-tone test method (vision carrier  $-8$  dB, sound carrier  $-7$  dB, sideband signal  $-16$  dB), zero dB corresponds to peak sync level.

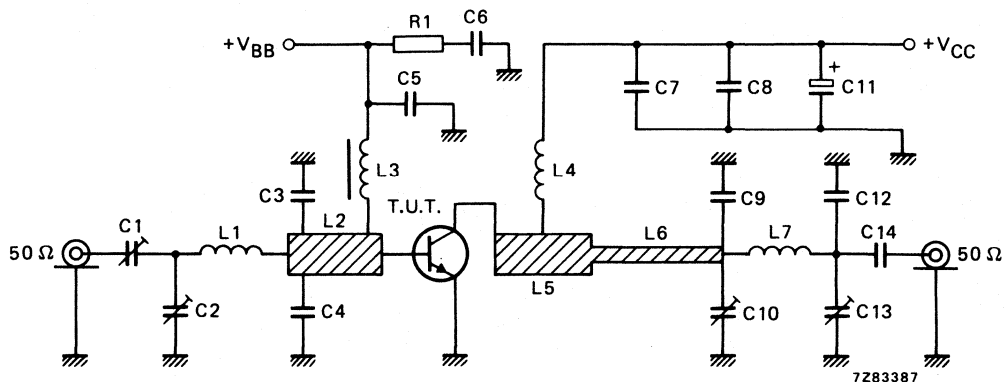


Fig. 8 Test circuit at  $f_{\text{vision}} = 224,25$  MHz.

## List of components:

- C1 = 1,8 to 10 pF film dielectric trimmer (cat. no. 2222 809 05002)
- C2 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)
- C3 = C4 = 82 pF multilayer ceramic chip capacitor (ATC<sup>▲</sup>), placed 7 mm from transistor edge
- C5 = C7 = C14 = 680 pF (50 V) multilayer ceramic chip capacitor (cat. no. 2222 852 13681)
- C6 = C8 = 330 nF polyester capacitor
- C9 = 43 pF (500 V) multilayer ceramic chip capacitor (ATC<sup>▲</sup>)
- C10 = C13 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)
- C11 = 10  $\mu\text{F}/40$  V solid aluminium electrolytic capacitor
- C12 = 18 pF (500 V) multilayer ceramic chip capacitor (ATC<sup>▲</sup>)
- L1 = 49 nH; 4 turns enamelled Cu wire (1,0 mm); int. dia. 3,6 mm; length 6,3 mm; leads 2 x 5 mm
- L2 = L5 = 30  $\Omega$  stripline (10,0 mm x 6,0 mm)
- L3 = 0,1  $\mu\text{H}$ ; microchoke (cat. no. 4322 057 01070)
- L4 = 130 nH; 6 turns enamelled Cu wire (1,0 mm); int. dia. 6,0 mm; length 10,7 mm; leads 2 x 5 mm
- L6 = 60  $\Omega$  stripline (50,5 mm x 2,0 mm)
- L7 = 30 nH; 4 turns enamelled Cu wire (1,0 mm); int. dia. 3,0 mm; length 7,9 mm; leads 2 x 5 mm
- L2, L5 and L6 are striplines on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric ( $\epsilon_r \approx 4,5$ ); thickness 1/16".
- R1 = 10  $\Omega$  carbon resistor

<sup>▲</sup> ATC means American Technical Ceramics.



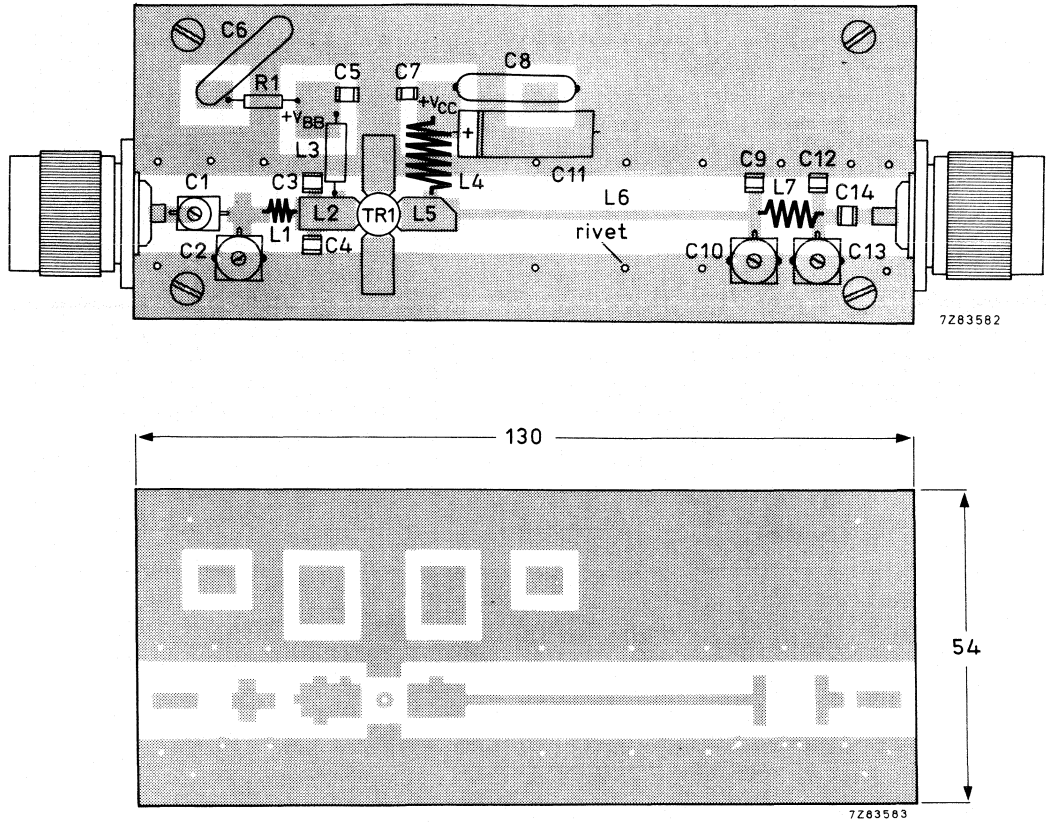


Fig. 9 Component layout and printed-circuit board for 224,25 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

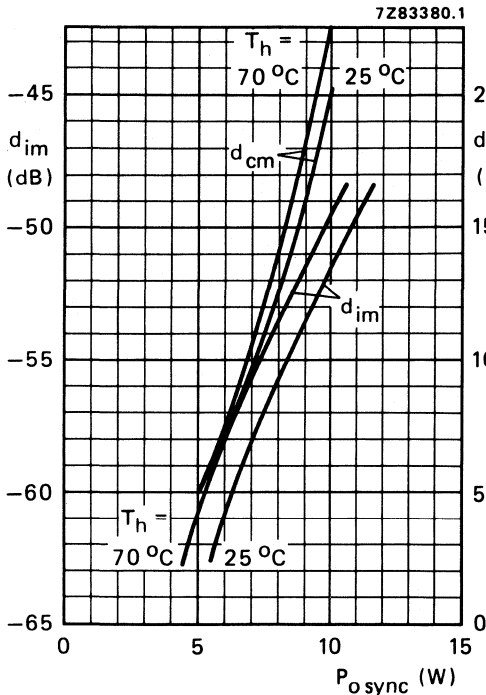


Fig. 10 Intermodulation distortion ( $d_{im}^*$ ) and cross-modulation distortion ( $d_{cm}^{**}$ ) as a function of output power.

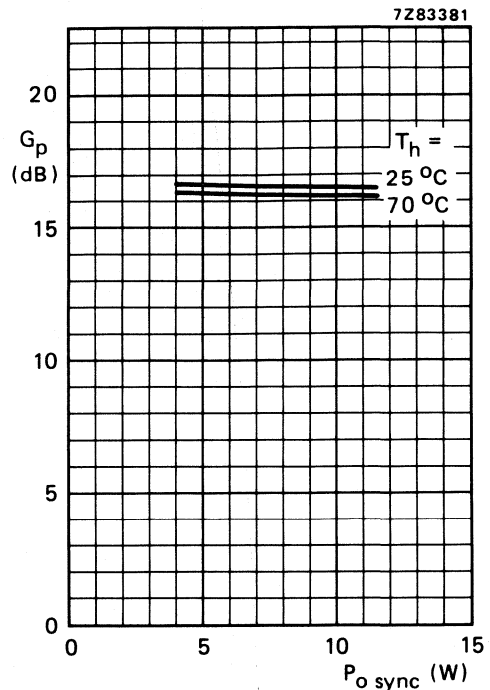


Fig. 11 Power gain as a function of output power.

Conditions for Figs 10 and 11:

Typical values;  $V_{CE} = 25\text{ V}$ ;  $I_C = 0,8\text{ A}$ ;  $f_{\text{vision}} = 224,25\text{ MHz}$ .

\* Three-tone test method (vision carrier  $-8\text{ dB}$ , sound carrier  $-7\text{ dB}$ , sideband signal  $-16\text{ dB}$ ), zero dB corresponds to peak sync level.

Intermodulation distortion of input signal  $\leq -75\text{ dB}$ .

\*\* Two-tone test method (vision carrier  $0\text{ dB}$ , sound carrier  $-7\text{ dB}$ ), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from  $0\text{ dB}$  to  $-20\text{ dB}$ .

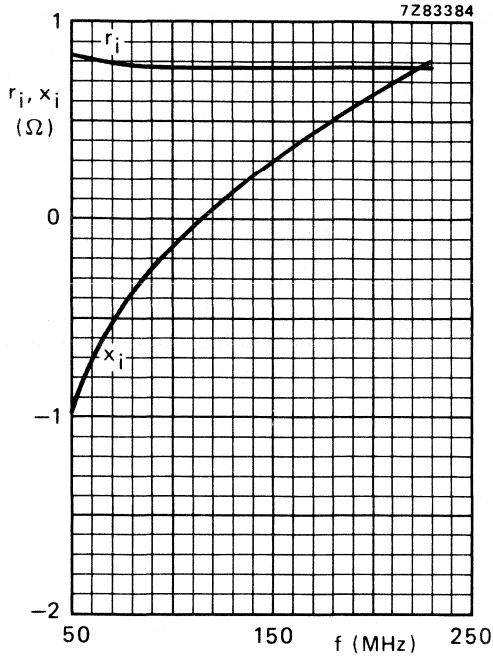


Fig. 12 Input impedance (series components).

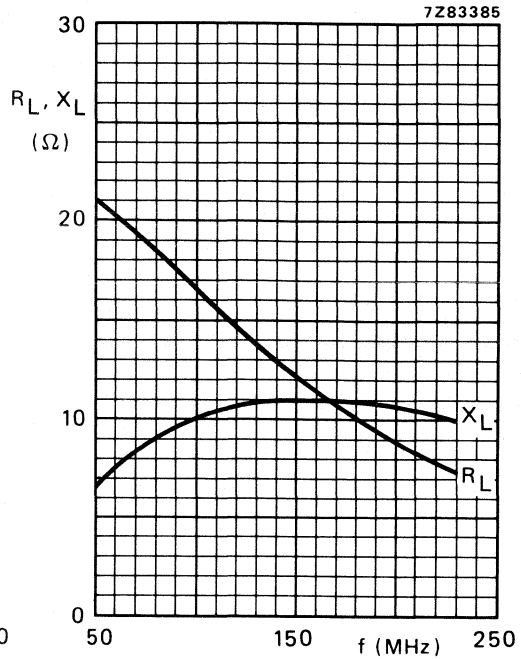


Fig. 13 Load impedance (series components).

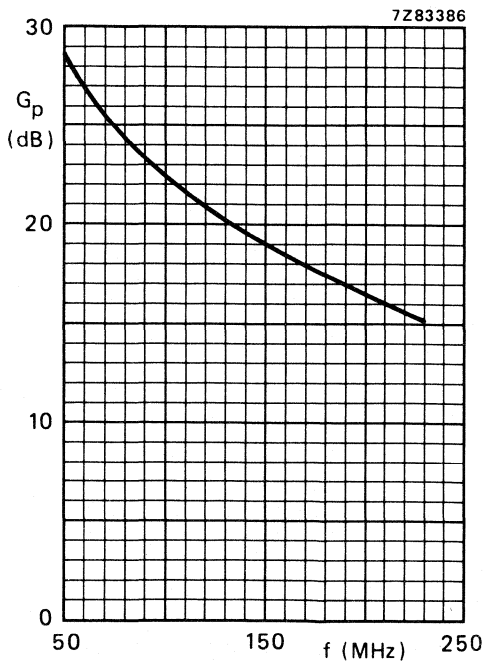


Fig. 14.

Conditions for Figs 12, 13 and 14:  
 Typical values;  $V_{CE} = 25$  V;  $I_C = 0,8$  A;  
 $T_h = 70$  °C.



## V.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in linear v.h.f. amplifiers of television transmitters and transposers.

### Features:

- diffused emitter ballasting resistors for an optimum temperature profile;
- gold metallization ensures excellent reliability.

The transistor has a  $\frac{3}{8}$ " 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance in linear amplifier

mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ A	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{o sync}}^*$ W	$G_{\text{p}}$ dB
class-A	224,25	25	1,5	70	-55	> 10	> 16
class-A	224,25	25	1,5	25	-55	typ. 12,5	typ. 17,2

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

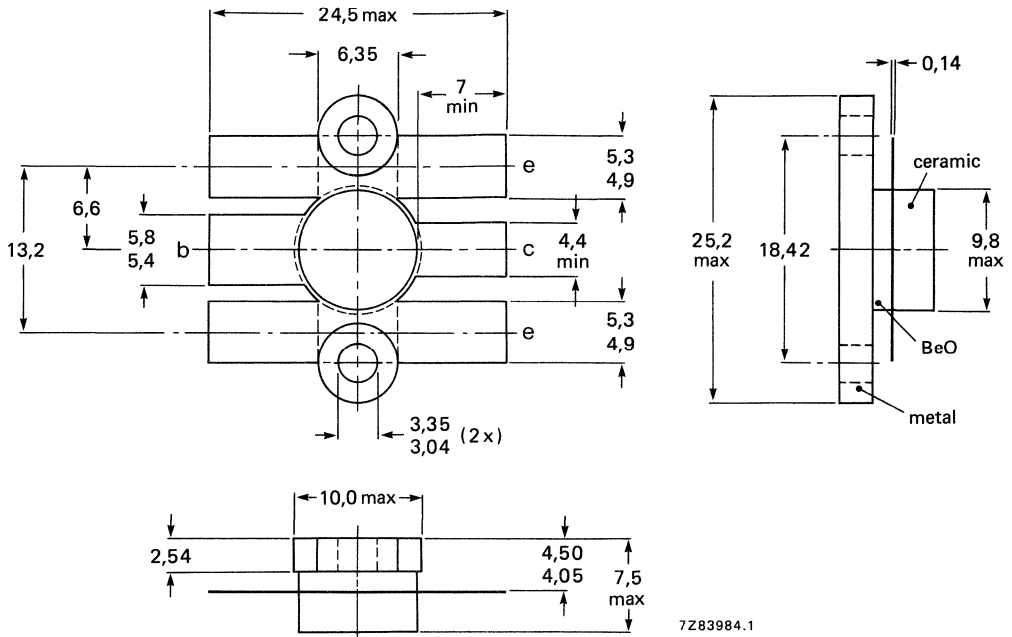
SOT-160 (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-160.

Dimensions in mm



7Z83984.1

Torque on screw: min. 0,6 Nm (6 kg cm)  
 max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage  
(peak value);  $V_{BE} = 0$   
open base

$V_{CESM}$  max. 60 V

$V_{CEO}$  max. 32 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current  
d.c. or average

$I_C; I_{C(AV)}$  max. 4 A

$I_{CM}$  max. 12 A

(peak value);  $f > 1$  MHz

Total power dissipation at  $T_{mb} = 25$  °C

$P_{tot}$  max. 82 W

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

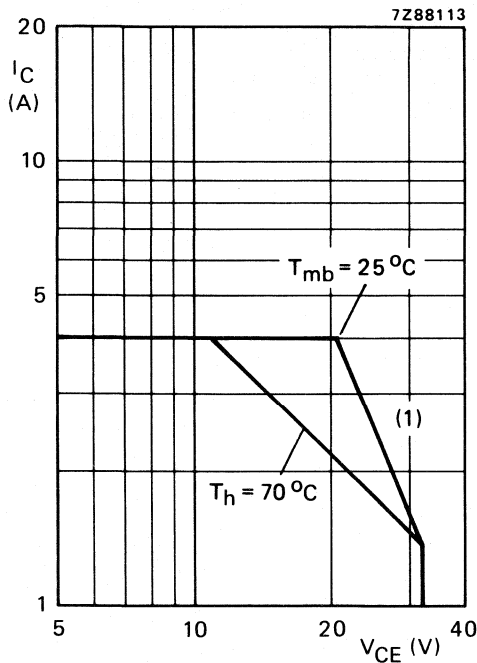
$P_{rf}$  max. 100 W

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

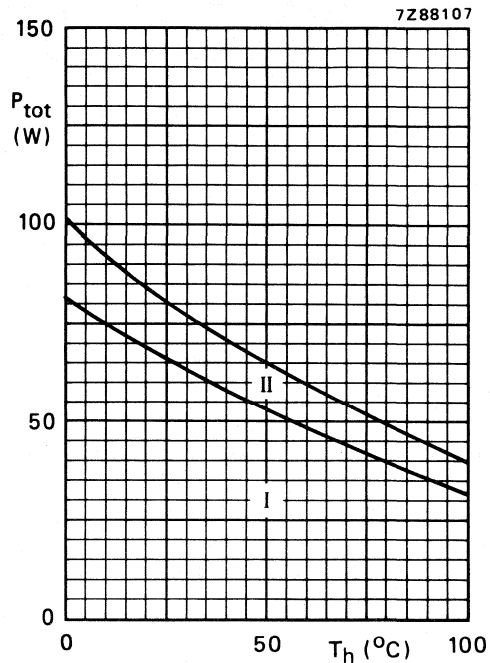


Fig. 3 Power derating curves vs. temperature.

- I Continuous d.c. (including r.f. class-A) operation
- II Continuous r.f. operation

**THERMAL RESISTANCE** (dissipation = 37,5 W;  $T_{mb} = 82$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th\ j-mb(dc)}$  = 2,55 K/W

From junction to mounting base (r.f. dissipation)

$R_{th\ j-mb(rf)}$  = 2,10 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,3 K/W

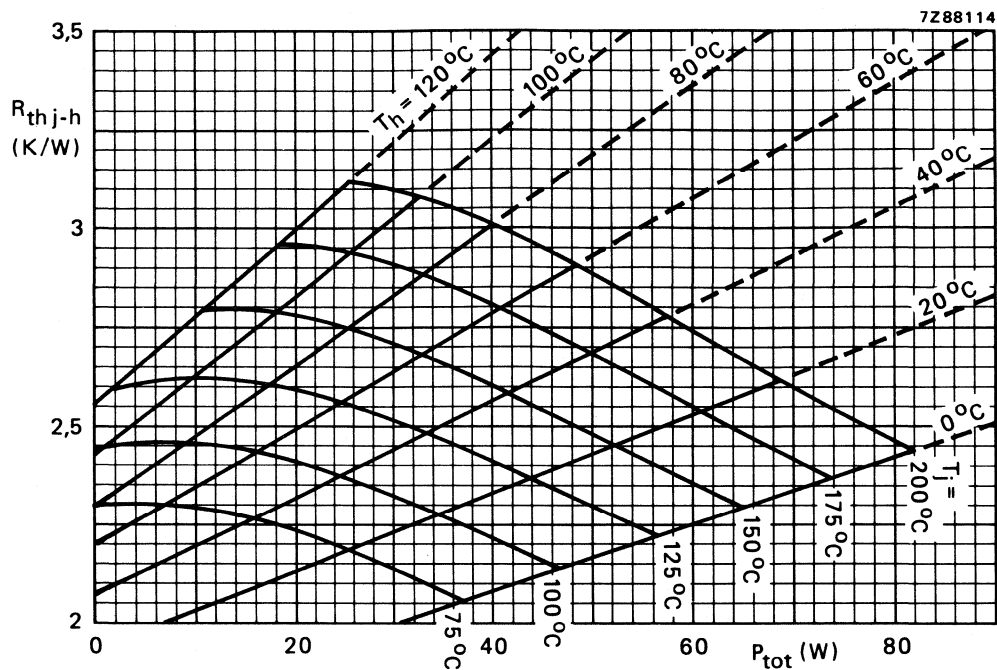


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,3\ K/W.$ )

#### Example

Nominal class-A operation (without r.f. signal):  $V_{CE} = 25\ V$ ;  $I_C = 1,5\ A$ ;  $T_h = 70\ ^\circ C$ .

Fig. 4 shows:  $R_{th\ j-h}$  max.  $2,85\ K/W$   
 $T_j$  max.  $177\ ^\circ C$

Typical device:  $R_{th\ j-h}$  typ.  $2,30\ K/W$   
 $T_j$  typ.  $156\ ^\circ C$



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 15\text{ mA}$ open base;  $I_C = 100\text{ mA}$  $V_{(BR)CES} > 60\text{ V}$  $V_{(BR)CEO} > 32\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 32\text{ V}$  $I_{CES} < 5\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 4,5\text{ mJ}$  $R_{BE} = 10\ \Omega$  $E_{SBR} > 4,5\text{ mJ}$ 

D.C. current gain\*

 $I_C = 1,6\text{ A}; V_{CE} = 25\text{ V}$  $h_{FE}$  typ. 50  
20 to 120

Collector-emitter saturation voltage\*

 $I_C = 3,5\text{ A}; I_B = 0,35\text{ A}$  $V_{CEsat}$  typ. 1,4 VTransition frequency at  $f = 500\text{ MHz}^{**}$  $-I_E = 1,6\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 2 GHz $-I_E = 3,5\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 2 GHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 25\text{ V}$  $C_C$  typ. 50 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 50\text{ mA}; V_{CE} = 25\text{ V}$  $C_{re}$  typ. 31 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 300\ \mu\text{s}; \delta \leq 0,02$ .\*\* Measured under pulse conditions:  $t_p \leq 50\ \mu\text{s}; \delta \leq 0,01$ .

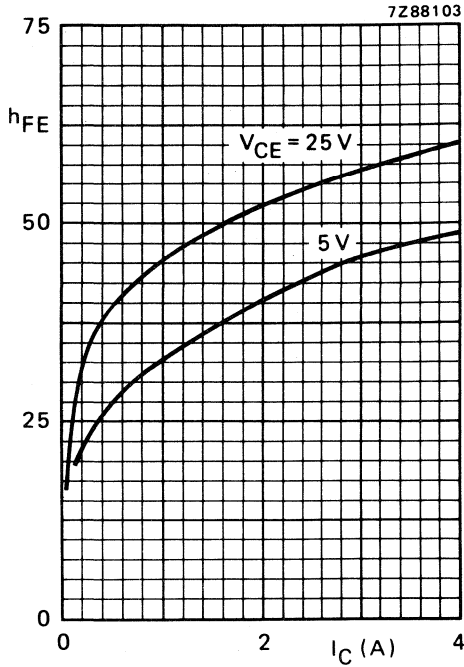


Fig. 5 Typical values;  $T_j = 25^\circ C$ .

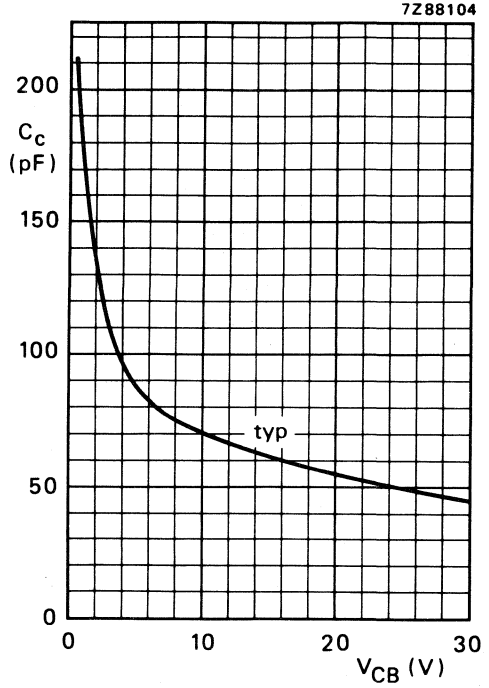


Fig. 6  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25^\circ C$ .

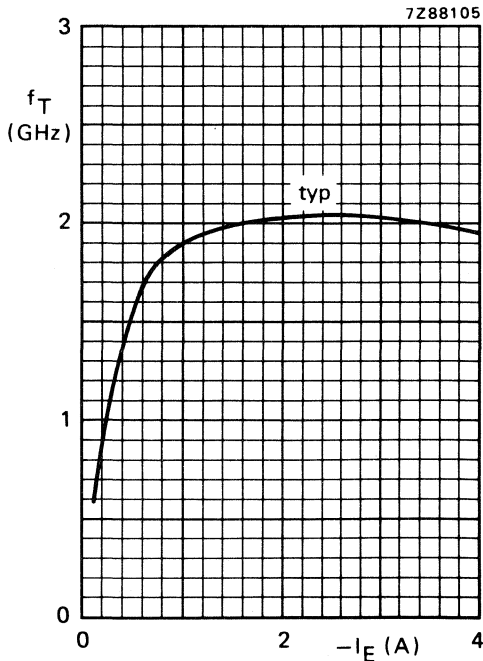


Fig. 7  $V_{CB} = 25V$ ;  $f = 500$  MHz;  $T_j = 25^\circ C$ .

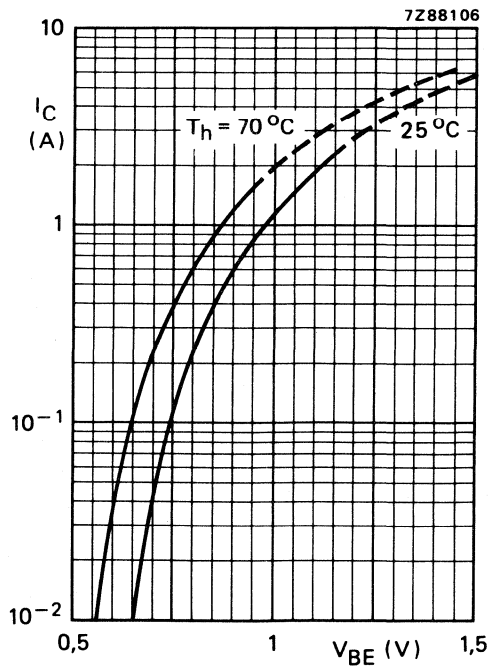


Fig. 8 Typical values;  $V_{CE} = 25V$ .

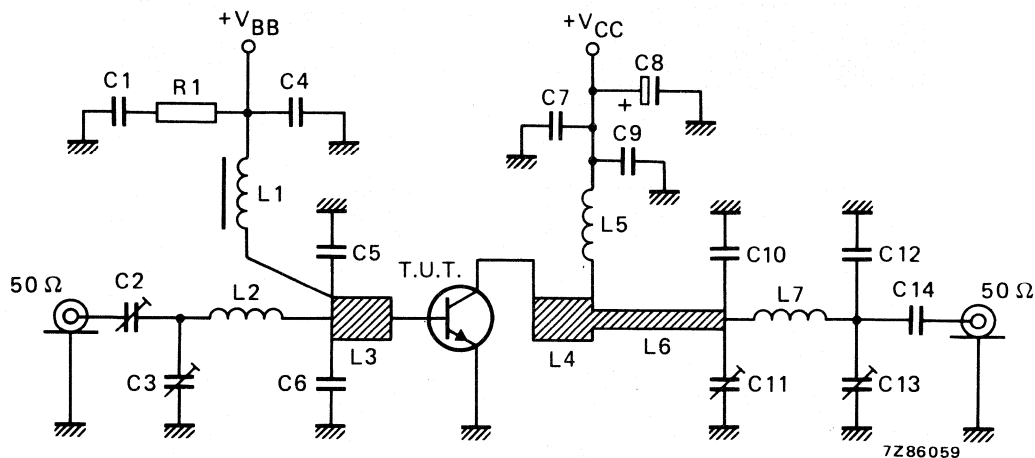
## APPLICATION INFORMATION

R.F. performance in v.h.f. class-A operation (linear power amplifier)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)*	$I_{\text{C}}$ (A)	$T_{\text{h}}$ (°C)	$d_{\text{im}}$ (dB)**	$P_{\text{O sync}}$ (W)**	$G_{\text{p}}$ (dB)
224,25	25	1,5	70	-55	> 10	> 16
			70	-55	typ. 11	typ. 16,8
			70	-52	typ. 13	typ. 16,8
			25	-55	typ. 12,5	typ. 17,2

\* The transistor is capable of operating up to 28 V.

\*\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

Fig. 9 Class-A test circuit at  $f_{\text{vision}} = 224,25$  MHz.

List of components:

C1 = C9 = 330 nF polyester capacitor

C2 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 05003)

C3 = C11 = C13 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)

C4 = C7 = C14 = 680 pF (50 V) multilayer ceramic chip capacitor (cat. no. 2222 852 13681)

C5 = C6 = 68 pF (500 V) multilayer ceramic chip capacitor (ATC<sup>▲</sup>)C8 = 10  $\mu$ F/63 V solid tantalum capacitorC10 = 82 pF (500 V) multilayer ceramic chip capacitor (ATC<sup>▲</sup>)C12 = 30 pF (500 V) multilayer ceramic chip capacitor (ATC<sup>▲</sup>)L1 = 1  $\mu$ H microchoke (cat. no. 4322 057 01080)

L2 = 3 turns enamelled Cu wire (1,6 mm); int. dia. 4,5 mm; length 14,0 mm; leads 2 x 3 mm

L3 = L4 = 32  $\Omega$  stripline (6,0 mm x 10,0 mm)

L5 = 4 turns enamelled Cu wire (1,6 mm); int. dia. 5,5 mm; length 10,0 mm; leads 2 x 2 mm

L6 = 62  $\Omega$  stripline (2,0 mm x 22,5 mm)

L7 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,5 mm; length 4,0 mm; leads 2 x 3 mm

L3, L4 and L6 are striplines on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric ( $\epsilon_r \approx 4,5$ ); thickness 1/16".R1 = 27  $\Omega$  carbon resistor<sup>▲</sup> ATC means American Technical Ceramics.

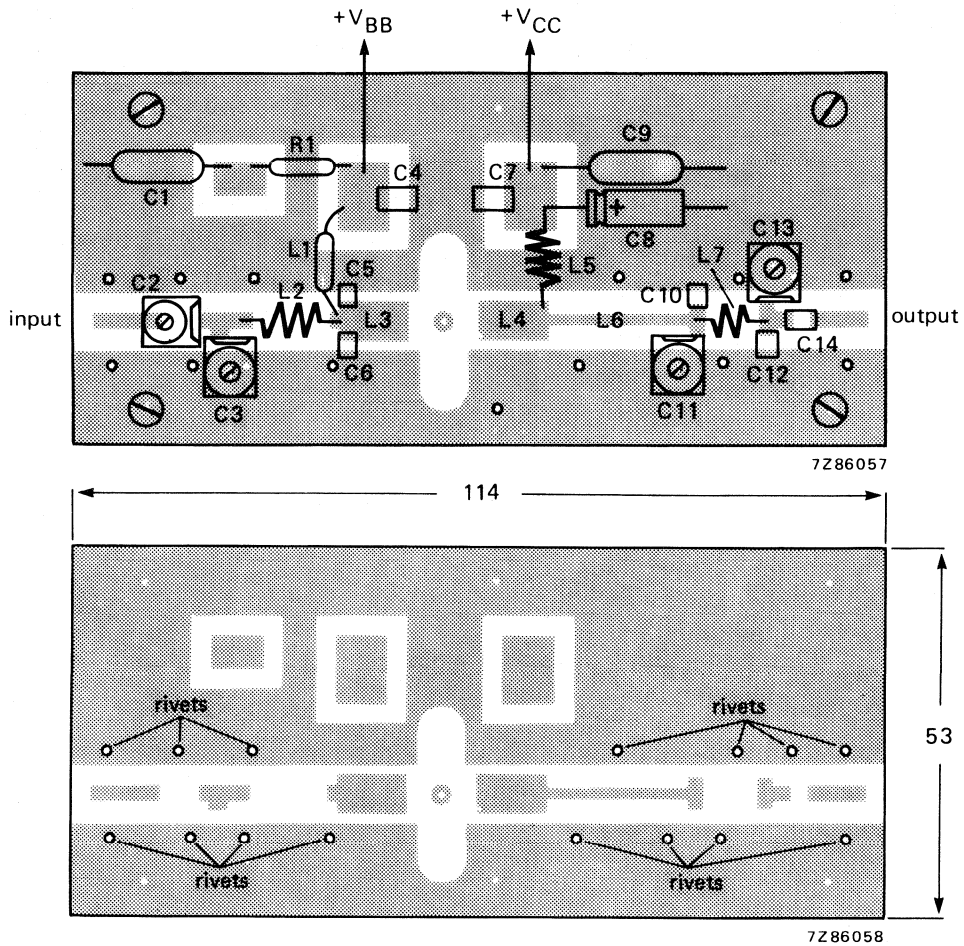


Fig. 10 Component layout and printed-circuit board for 224,25 MHz class-A test circuit.

The circuit and the components are on one side of the epoxy fibre-glass board, the other side is unetched copper to serve as a ground-plane. Earth connections are made by hollow rivets. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.

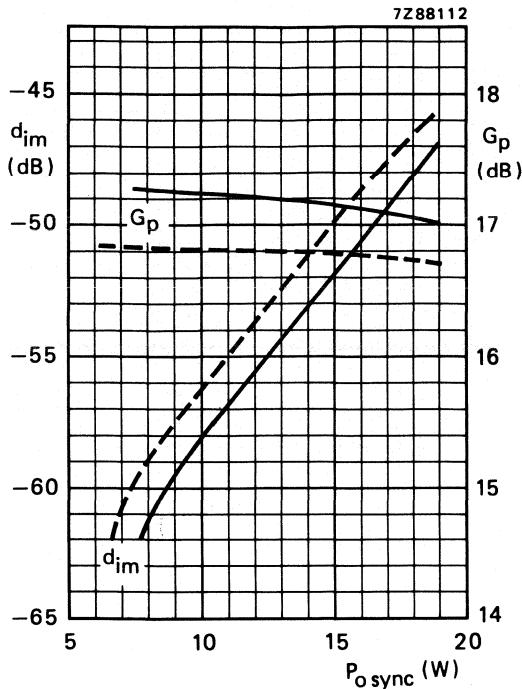


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and power gain as a function of output power.

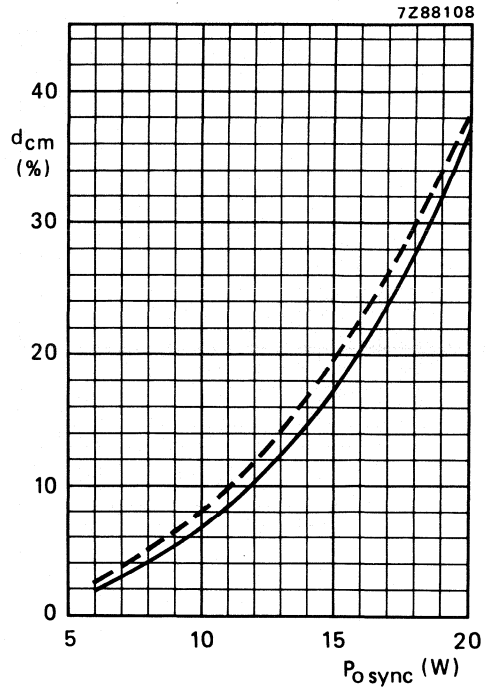


Fig. 12 Cross-modulation distortion ( $d_{cm}$ )\*\* as a function of output power.

Conditions for Figs 11 and 12:

Typical values;  $V_{CE} = 25$  V;  $I_C = 1,5$  A; —  $T_h = 25$  °C; - - -  $T_h = 70$  °C;  $f_{vision} = 224,25$  MHz.

**Ruggedness in class-A operation**

The BLV32F is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 15 W (r.m.s. value) or 20 W (P.E.P.) under the following conditions:

$V_{CE} = 25$  V;  $I_C = 1,5$  A;  $T_h = 70$  °C;  $f = 224,25$  MHz;  $R_{th\ mb-h} = 0,3$  K/W.

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

Intermodulation distortion of input signal  $\leq -70$  dB.

\*\* Two-tone test method (vision carrier 0 dB, sound carrier -7 dB), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from 0 dB to -20 dB.

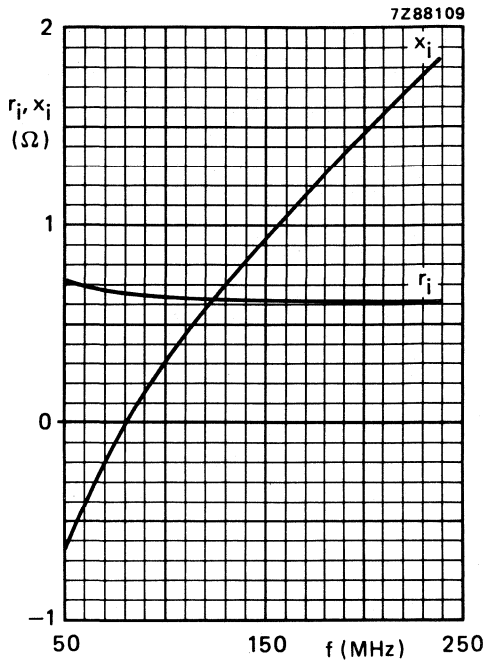


Fig. 13 Input impedance (series components).

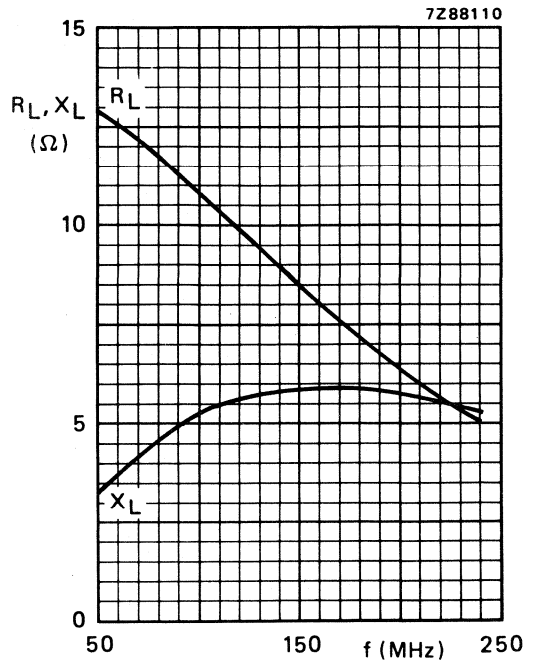


Fig. 14 Load impedance (series components).

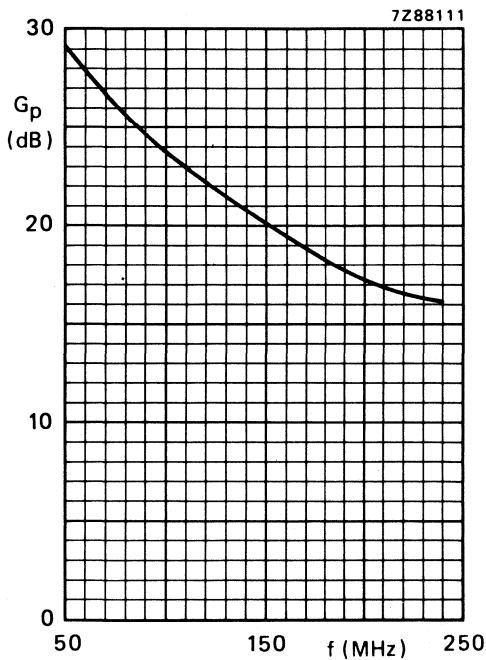


Fig. 15.

Conditions for Figs 13, 14 and 15:  
 Typical values;  $V_{CE} = 25$  V;  $I_C = 1,5$  A;  
 class-A operation;  $T_h = 70$  °C.

## V.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in linear v.h.f. amplifiers for television transmitters and transposers. Diffused emitter ballasting resistors and the application of **gold sandwich metallization** ensure an optimum temperature profile and excellent reliability properties.

The transistor has a 1/2" capstan envelope with ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

R.F. performance in linear amplifier

mode of operation	f <sub>vision</sub> MHz	V <sub>CE</sub> V	I <sub>C</sub> I <sub>C(ZS)</sub> A	T <sub>h</sub> °C	d <sub>im</sub> * dB	P <sub>o sync</sub> * W	G <sub>p</sub> dB	sync compr.** sync in (%) / sync out (%)
class-A	224,25	25	3,20	70 25	-55 -55	> 19 typ. 26	> 9 typ. 9,7	
class-AB	224,25	28	0,10	70		typ. 90	typ. 6,5	30/25

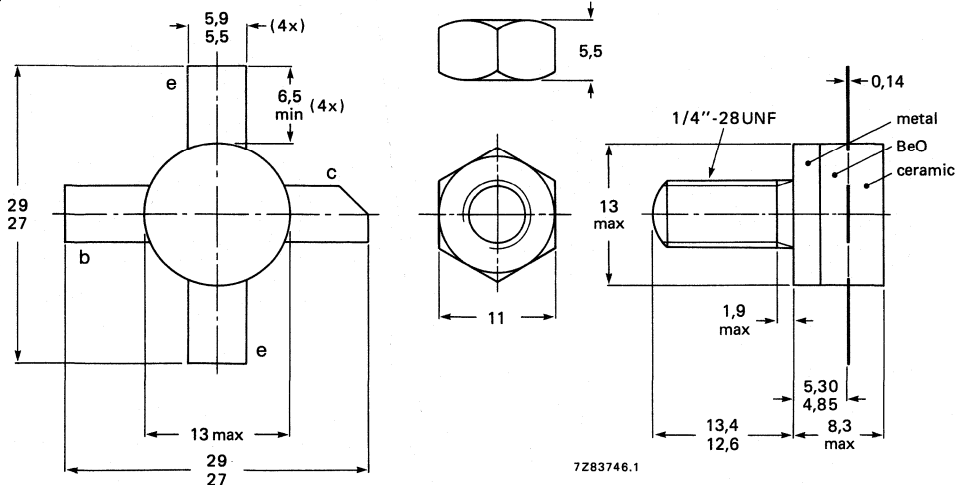
\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

\*\* Television service (negative modulation, C.C.I.R. system).

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-147.



Torque on nut: min. 2,3 Nm  
(23 kg cm)  
max. 2,7 Nm  
(27 kg cm)

Diameter of clearance hole in heatsink: max. 6,4 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage  
(peak value);  $V_{BE} = 0$

open base

Emitter-base voltage (open collector)

Collector current

d.c. or average

(peak value);  $f > 1$  MHz

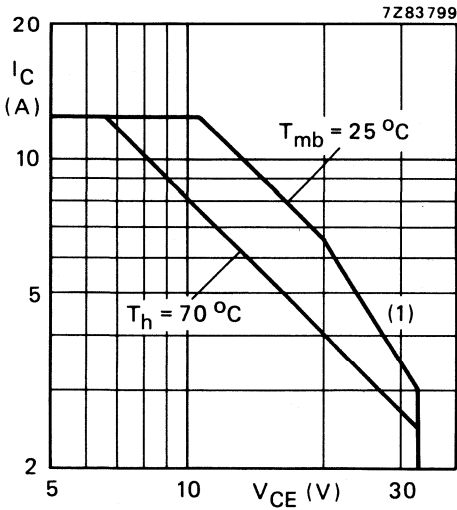
Total power dissipation at  $T_{mb} = 25$  °C

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

Storage temperature

Operating junction temperature

$V_{CESM}$	max.	65 V
$V_{CEO}$	max.	33 V
$V_{EBO}$	max.	4 V
$I_C; I_{C(AV)}$	max.	12,5 A
$I_{CM}$	max.	20 A
$P_{tot}$	max.	132 W
$P_{rf}$	max.	165 W
$T_{stg}$		-65 to + 150 °C
$T_j$	max.	200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

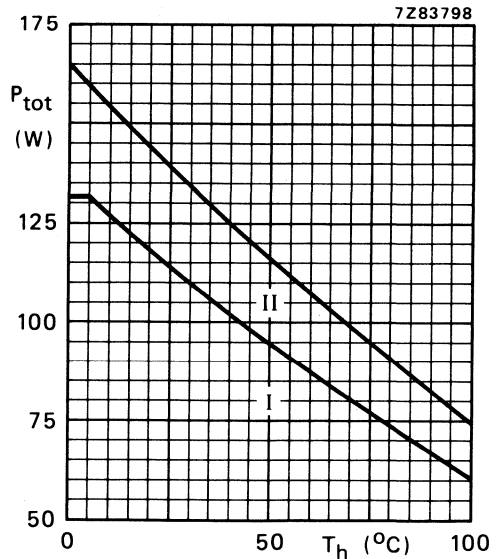


Fig. 3 Power derating curve vs. temperature.

- I Continuous d.c. (including r.f. class-A) operation
- II Continuous r.f. operation

**THERMAL RESISTANCE** (dissipation = 80 W;  $T_{mb} = 82$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th\ j-mb(dc)} = 1,46$  K/W

From junction to mounting base (r.f. dissipation)

$R_{th\ j-mb(rf)} = 1,17$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0,15$  K/W



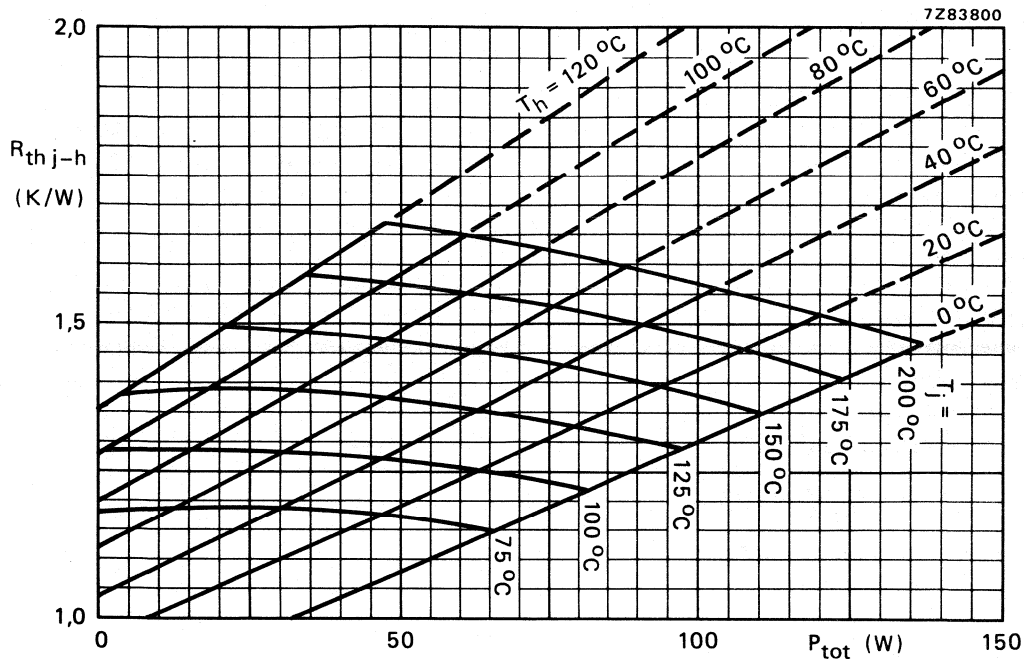


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,15\text{ K/W.}$ )

#### Example

Nominal class-A operation:  $V_{CE} = 25\text{ V}$ ;  $I_C = 3,2\text{ A}$ ;  $T_h = 70\text{ }^\circ\text{C}$ .

Fig. 4 shows:  $R_{th\ j-h}$  max.  $1,60\text{ K/W}$   
 $T_j$  max.  $198\text{ }^\circ\text{C}$

Typical device:  $R_{th\ j-h}$  typ.  $1,50\text{ K/W}$   
 $T_j$  typ.  $190\text{ }^\circ\text{C}$

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 25\text{ mA}$ open base;  $I_C = 100\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$  $V_{(BR)CEO} > 33\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 30\text{ V}$  $I_{CES} < 10\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 12,5\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $E_{SBR} > 12,5\text{ mJ}$ 

D.C. current gain\*

 $I_C = 3,0\text{ A}; V_{CE} = 25\text{ V}$  $h_{FE}$  typ. 50  
15 to 100

Collector-emitter saturation voltage\*

 $I_C = 6,0\text{ A}; I_B = 0,6\text{ A}$  $V_{CEsat}$  typ. 0,75 VTransition frequency at  $f = 100\text{ MHz}^{**}$  $-I_E = 3,0\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 680 MHz $-I_E = 6,0\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 750 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 25\text{ V}$  $C_C$  typ. 155 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 25\text{ V}$  $C_{re}$  typ. 88 pF

Collector-stud capacitance

 $C_{cs}$  typ. 3 pF\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0,02$ .\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}; \delta \leq 0,01$ .

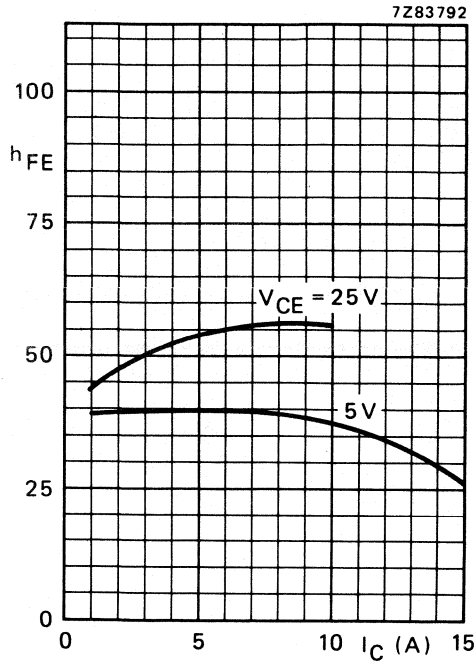


Fig. 5 Typical values;  $T_j = 25^\circ C$ .

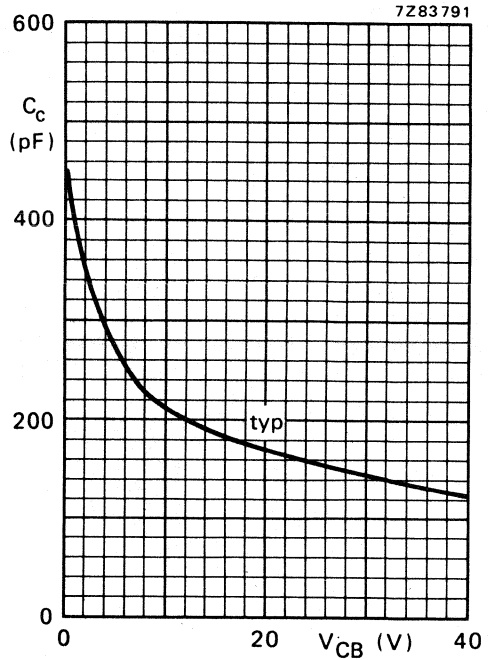


Fig. 6  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25^\circ C$ .

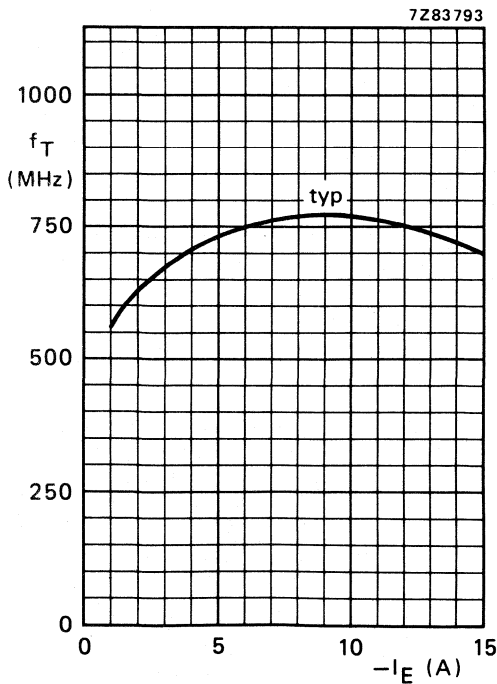


Fig. 7  $V_{CB} = 25V$ ;  $f = 100$  MHz;  $T_j = 25^\circ C$ .

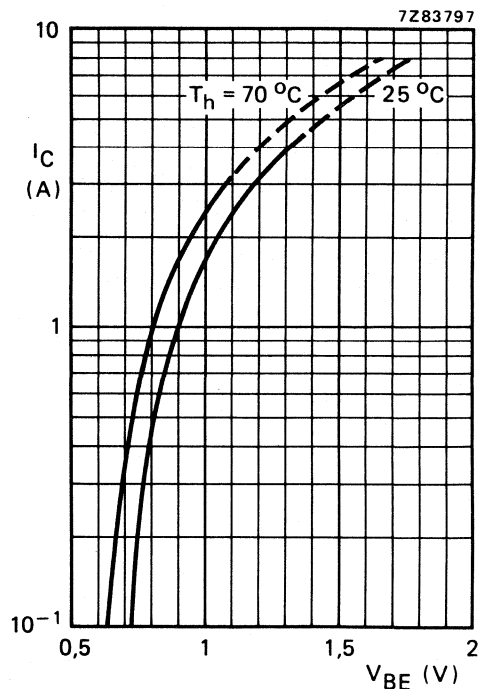


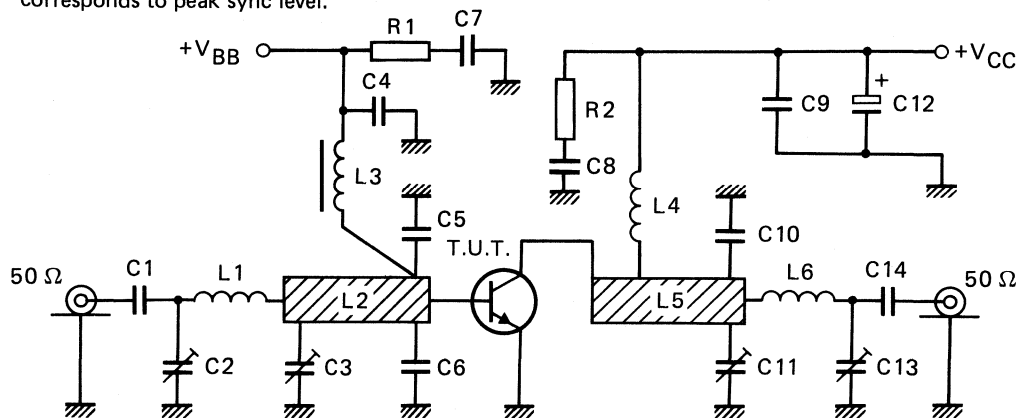
Fig. 8 Typical values;  $V_{CE} = 25V$ .

## APPLICATION INFORMATION

R.F. performance in v.h.f. class-A operation (linear power amplifier)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (A)	$T_{\text{h}}$ (°C)	$d_{\text{im}}$ (dB)*	$P_{\text{O sync}}$ (W)*	$G_{\text{p}}$ (dB)
224,25	25	3,2	70	-55	> 19	> 9
			70	-55	typ. 22	typ. 9,3
			70	-52	typ. 26,5	typ. 9,3
			25	-55	typ. 26	typ. 9,7

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

Fig. 9 Class-A test circuit at  $f_{\text{vision}} = 224,25$  MHz.

7Z83801.1

List of components:

C1 = C14 = 680 pF (500 V) multilayer ceramic chip capacitor (ATC▲)

C2 = C11 = C13 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 08002)

C3 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)

C4 = C9 = 680 pF (50 V) multilayer ceramic chip capacitor (cat. no. 2222 852 13681)

C5 = C6 = 68 pF (500 V) multilayer ceramic chip capacitor (ATC▲), placed 2 mm from transistor edge

C7 = C8 = 470 nF (50 V) multilayer ceramic chip capacitor (cat. no. 2222 856 48474)

C10 = 24 pF (500 V) multilayer ceramic chip capacitor (ATC▲), positioned under C11

C12 = 10  $\mu$ F/40 V solid aluminium electrolytic capacitor

L1 = 1½ turns closely wound enamelled Cu wire (1,6 mm); int. dia. 4,5 mm; leads 2 x 3 mm

L2 = 30  $\Omega$  stripline (6,0 mm x 32,7 mm)L3 = 1  $\mu$ H microchoke (cat. no. 4322 057 01080)

L4 = 27 nH; 2 turns enamelled Cu wire (1,1 mm); int. dia. 4,5 mm; length 2,9 mm; leads 2 x 5 mm

L5 = 30  $\Omega$  stripline (6,0 mm x 24,0 mm)

L6 = 19 nH; 2 turns enamelled Cu wire (1,1 mm); int. dia. 3,5 mm; length 3,5 mm; leads 2 x 5 mm

L2 and L5 are striplines on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric ( $\epsilon_r \approx 4,5$ ); thickness 1/16".R1 = R2 = 10  $\Omega$  carbon resistor

▲ ATC means American Technical Ceramics.

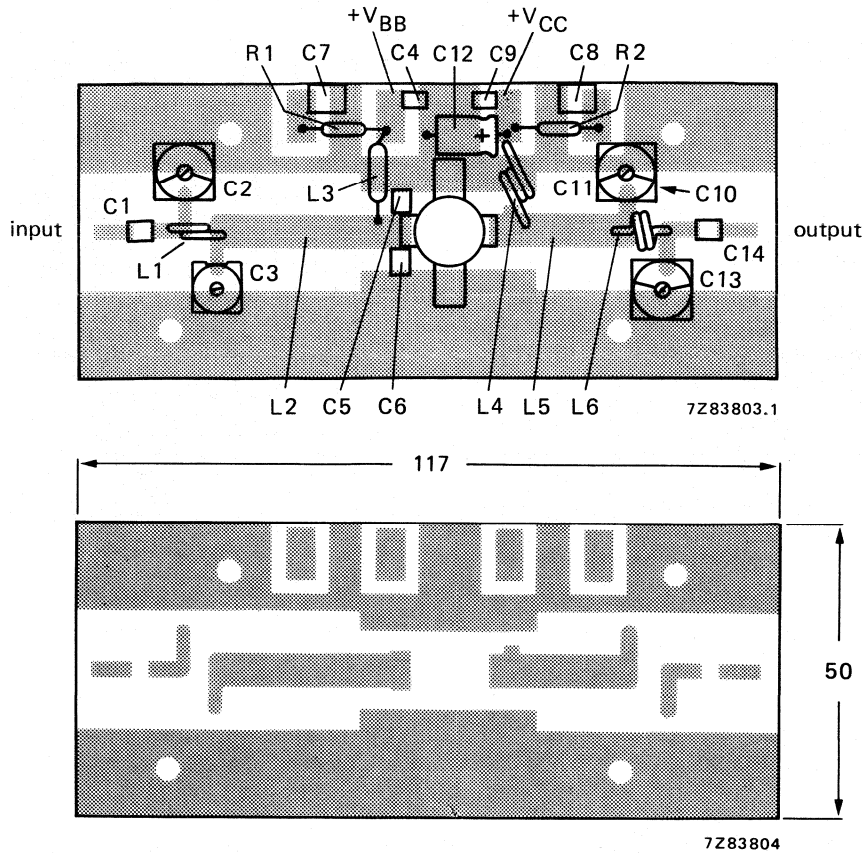


Fig. 10 Component layout and printed-circuit board for 224,25 MHz class-A test circuit.

The circuit and the components are on one side of the epoxy fibre-glass board, the other side is un-etched copper to serve as earth. Earth connections are made by hollow rivets. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.

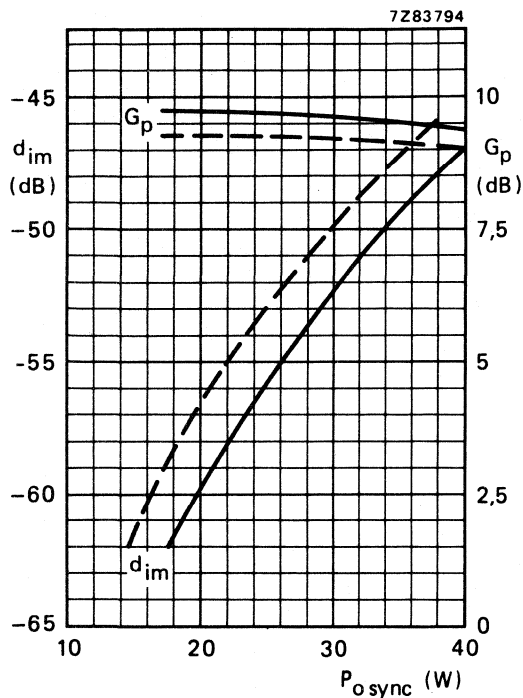


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and power gain as a function of output power.

Conditions for Figs 11 and 12:

Typical values;  $V_{CE} = 25$  V;  $I_C = 3,2$  A; ———  $T_h = 25^\circ C$ ; - - -  $T_h = 70^\circ C$ ;  $f_{vision} = 224,25$  MHz.

**Ruggedness in class-A operation**

The BLV33 is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 30 W (r.m.s. value) or 40 W (P.E.P.) under the following conditions:

$V_{CE} = 25$  V;  $I_C = 3,2$  A;  $T_h = 70^\circ C$ ;  $f = 224,25$  MHz;  $R_{th\ mb-h} = 0,15$  K/W.

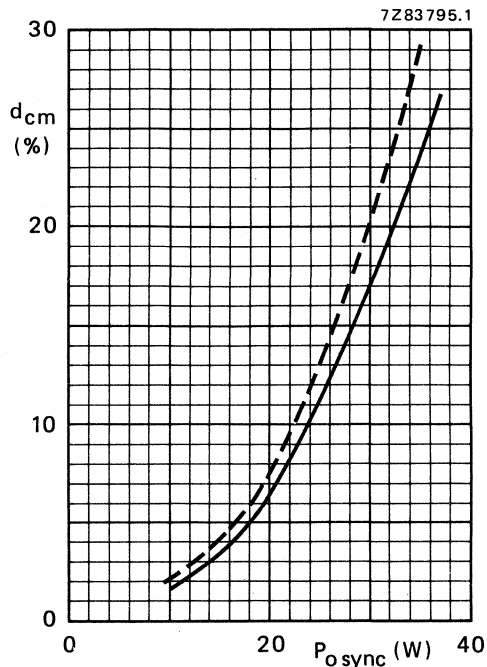


Fig. 12 Cross-modulation distortion ( $d_{cm}$ )\*\* as a function of output power.

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.  
Intermodulation distortion of input signal  $\leq -70$  dB.

\*\* Two-tone test method (vision carrier 0 dB, sound carrier -7 dB), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from 0 dB to -20 dB.

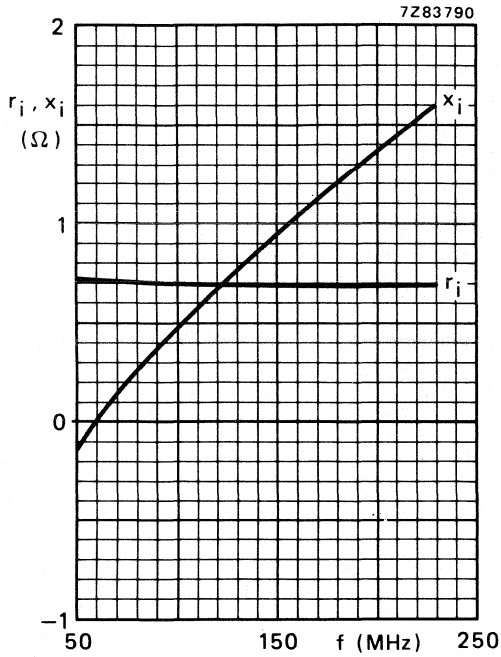


Fig. 13 Input impedance (series components).

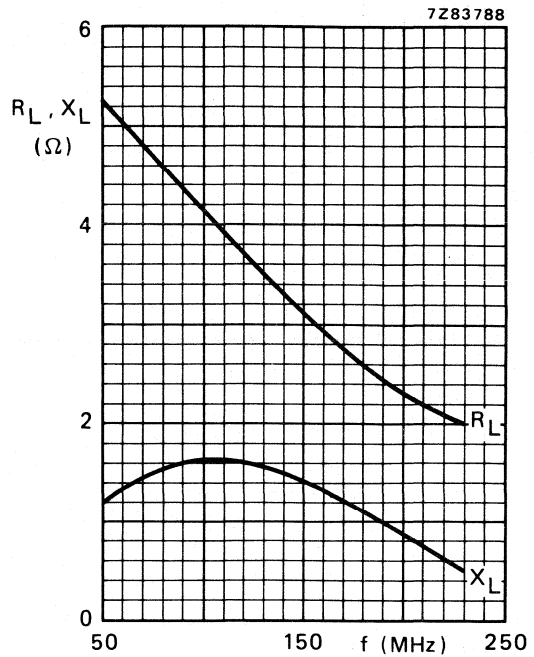


Fig. 14 Load impedance (series components).

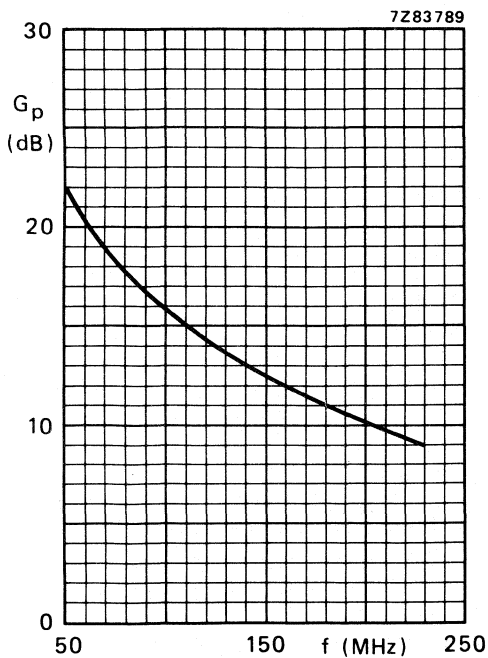


Fig. 15.

Conditions for Figs 13, 14 and 15:

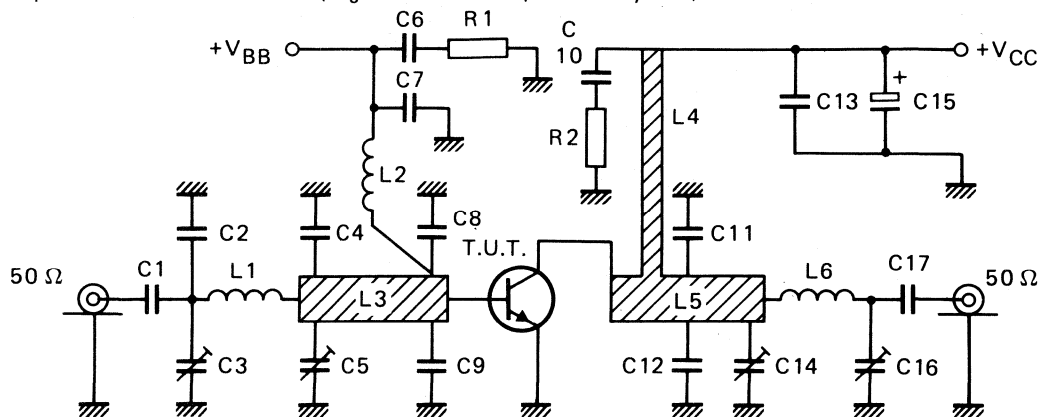
Typical values;  $V_{CE} = 25$  V;  $I_C = 3,2$  A;  
class-A operation;  $T_h = 70$  °C.

## APPLICATION INFORMATION

R.F. performance in v.h.f. class-AB operation (c.w.)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C(ZS)}}$ (A)	$T_{\text{h}}$ (°C)	$P_{\text{L}}$ (W)	$I_{\text{C}}$ (A)	$\eta$ (%)	$G_{\text{p}}$ (dB)*
224,25	28	0,1	70	40 90	typ. 2,60 typ. 4,46	typ. 55 typ. 72	typ. 7,5 typ. 6,5

\* Gain compression point of 1 dB is at typical 90 W (minimum 80 W). Using a 3rd-order amplitude transfer characteristic, 1 dB compression corresponds with 30% sync input/25% sync output compression in television service (negative modulation, C.C.I.R. system).

Fig. 16 Class-AB test circuit at  $f_{\text{vision}} = 224,25$  MHz.

7283802

List of components:

- C1 = C17 = 680 pF (500 V) multilayer ceramic chip capacitor (ATC▲)  
 C2 = 39 pF (500 V) multilayer ceramic chip capacitor (ATC▲)  
 C3 = C16 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)  
 C4 = 43 pF (500 V) multilayer ceramic chip capacitor (ATC▲)  
 C5 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 08002)  
 C6 = C10 = 330 nF polyester capacitor  
 C7 = C13 = 680 pF (500 V) multilayer ceramic chip capacitor (cat. no. 2222 852 13681)  
 C8 = C9 = 68 pF (500 V) multilayer ceramic chip capacitor (ATC▲); placed 2,5 mm from transistor edge  
 C11 = C12 = 27 pF (500 V) multilayer ceramic chip capacitor (ATC▲); placed 7 mm from transistor edge  
 C14 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 08003)  
 C15 = 10  $\mu$ F/40 V solid aluminium electrolytic capacitor  
 L1 = 25 nH; 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,3 mm; length 3,4 mm; leads 2 x 5 mm  
 L2 = 120 nH; 4 turns closely wound enamelled Cu wire (1,1 mm); int. dia. 6,0 mm; leads 2 x 5 mm  
 L3 = 30  $\Omega$  stripline (6,0 mm x 48,8 mm)  
 L4 = 48  $\Omega$  stripline (3,0 mm x 27,0 mm) at 3 mm from transistor edge  
 L5 = 30  $\Omega$  stripline (6,0 mm x 42,9 mm)  
 L6 = 24 nH; 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,0 mm; length 3,4 mm; leads 2 x 5 mm  
 L3, L4 and L5 are striplines on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric ( $\epsilon_r \approx 4,5$ ); thickness 1/16".  
 R1 = R2 = 10  $\Omega$  carbon resistor

▲ ATC means American Technical Ceramics.



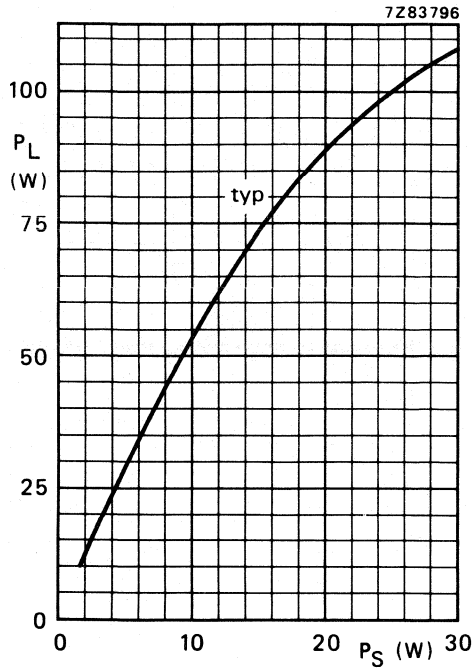


Fig. 17  $V_{CE} = 28$  V;  $I_{C(ZS)} = 0,1$  A;  $T_h = 70$  °C;  $f_{vision} = 224,25$  MHz.

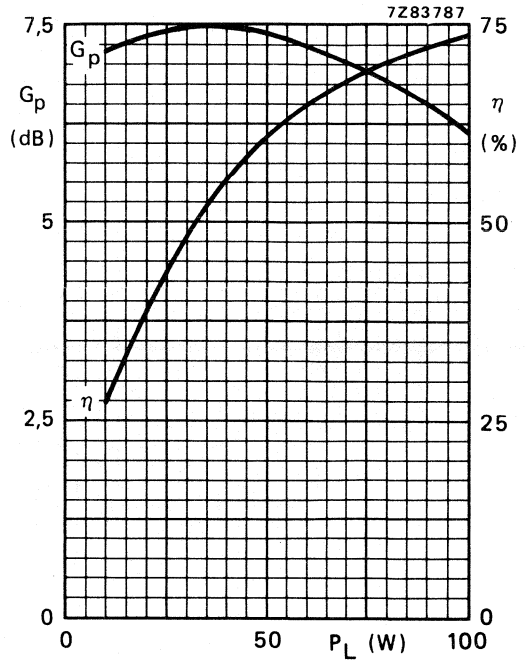


Fig. 18  $V_{CE} = 28$  V;  $I_{C(ZS)} = 0,1$  A;  $T_h = 70$  °C;  $f_{vision} = 224,25$  MHz; typical values.

**Ruggedness in class-AB operation**

The BLV33 is capable of withstanding a load mismatch ( $VSWR \leq 2$  through all phases) up to 60 W (r.m.s. value) and 90 W (P.E.P.) under the following conditions:

$V_{CE} = 28$  V;  $T_h = 70$  °C;  $f = 224,25$  MHz;  $R_{th\ mb-h} = 0,15$  K/W.

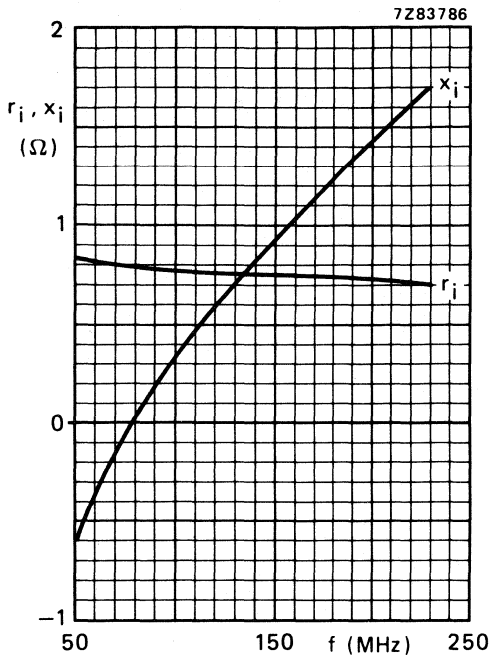


Fig. 19 Input impedance (series components).

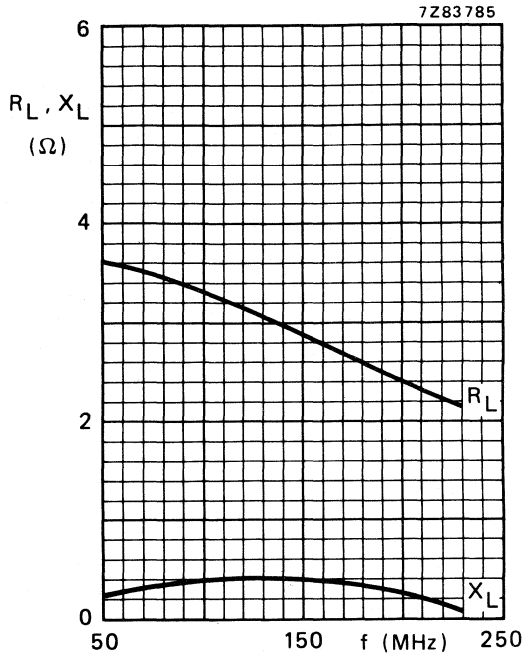


Fig. 20 Load impedance (series components).

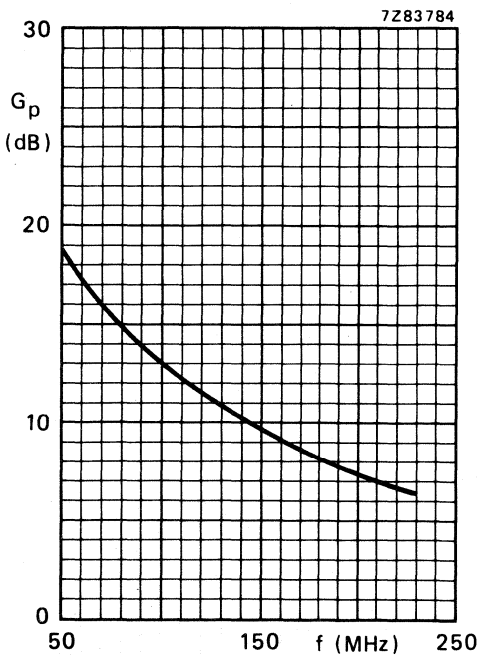


Fig. 21.

Conditions for Figs 19, 20 and 21:

Typical values;  $V_{CE} = 28$  V;  $P_L = 80$  W (P.E.P.);  
class-AB operation;  $T_h = 70$  °C.

## V.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in linear v.h.f. amplifiers for television transmitters and transposers.

Features of this product:

- internally matched input for wideband operation and high power gain;
- diffused emitter ballasting resistors for an optimum temperature profile;
- gold metallization ensures excellent reliability.

The transistor has a ½" 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance in linear amplifier

mode of operation	f <sub>vision</sub> MHz	V <sub>CE</sub> V	I <sub>C</sub> I <sub>C(ZS)</sub> A	T <sub>h</sub> °C	d <sub>im</sub> * dB	P <sub>o sync</sub> * W	G <sub>p</sub> dB	sync compr.** sync in (%)/sync out (%)
class-A	224,25	25	3,20	70 25	-55 -55	> 16 typ. 22	> 13,5 typ. 14,8	
class-AB	224,25	28	0,20	70		typ. 85	typ. 10,5	30/25

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

\*\* Television service (negative modulation, C.C.I.R. system).

### MECHANICAL DATA

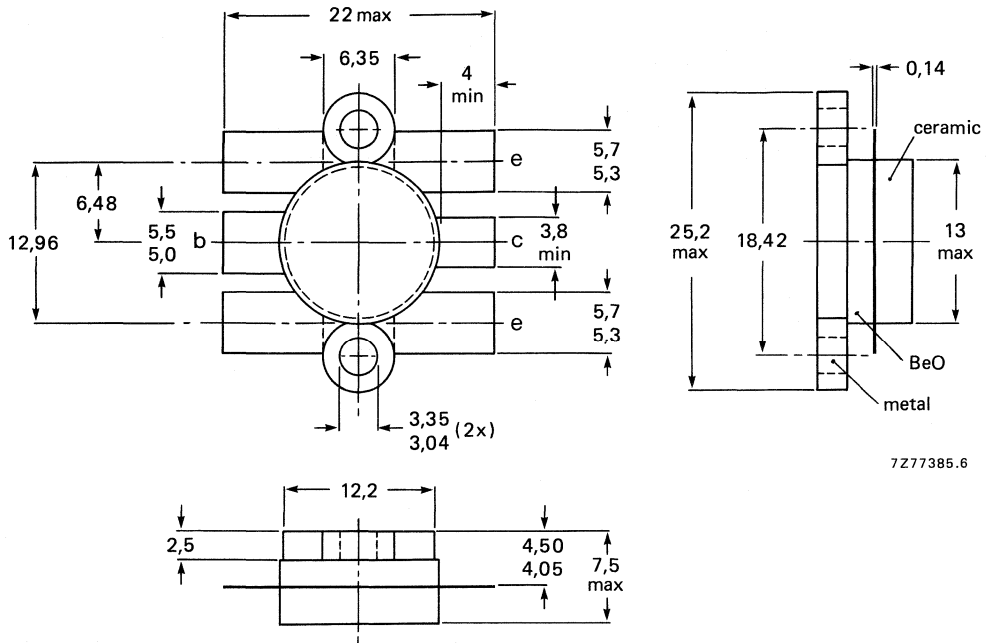
SOT-119 (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-119.

Dimensions in mm



7277385.6

Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage  
(peak value);  $V_{BE} = 0$

open base

Emitter-base voltage (open collector)

Collector current

d.c. or average

(peak value);  $f > 1$  MHz

Total power dissipation at  $T_{mb} = 25$  °C

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

Storage temperature

Operating junction temperature

$V_{CESM}$  max. 65 V

$V_{CEO}$  max. 33 V

$V_{EBO}$  max. 4 V

$I_C; I_{C(AV)}$  max. 12,5 A

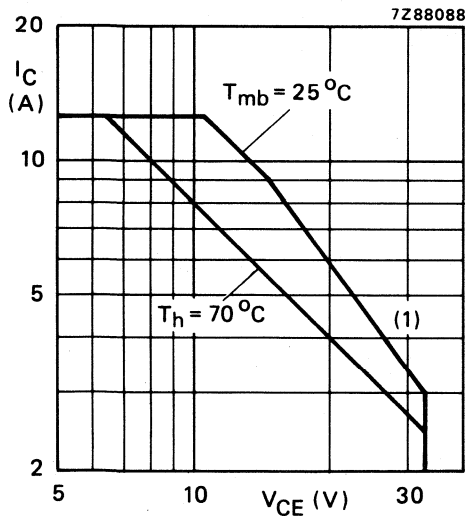
$I_{CM}$  max. 20 A

$P_{tot}$  max. 133 W

$P_{rf}$  max. 162 W

$T_{stg}$  -65 to + 150 °C

$T_j$  max. 200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

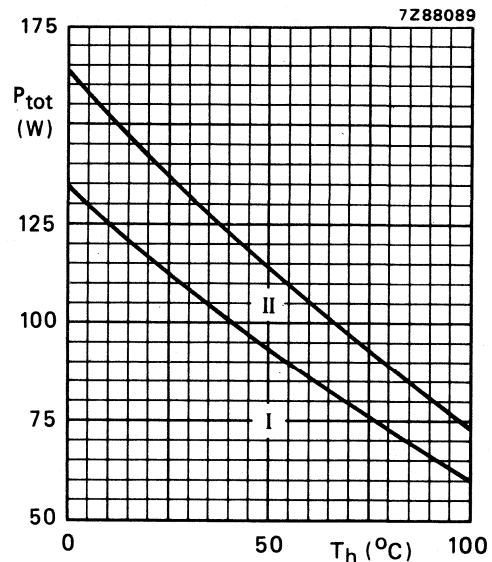


Fig. 3 Power derating curve vs. temperature.

I Continuous d.c. (including r.f. class-A) operation

II Continuous r.f. operation

**THERMAL RESISTANCE** (dissipation = 80 W;  $T_{mb} = 86$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th j-mb(dc)}$  = 1,43 K/W

From junction to mounting base (r.f. dissipation)

$R_{th j-mb(rf)}$  = 1,17 K/W

From mounting base to heatsink

$R_{th mb-h}$  = 0,2 K/W

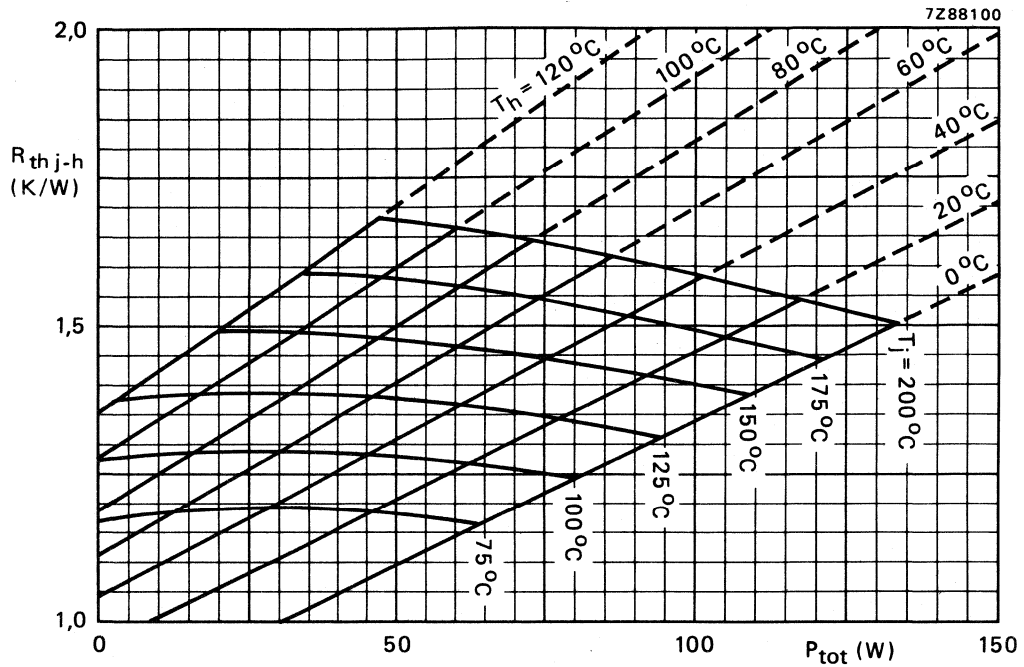


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,2\ K/W.$ )

**Example**

Nominal class-A operation (without r.f. signal):  $V_{CE} = 25\ V$ ;  $I_C = 3,2\ A$ ;  $T_h = 70\ ^\circ C$ .

Fig. 4 shows:  $R_{th\ j-h}$  max. 1,63 K/W  
 $T_j$  max. 200 °C

Typical device:  $R_{th\ j-h}$  typ. 1,53 K/W  
 $T_j$  typ. 192 °C

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 25\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$ open base;  $I_C = 100\text{ mA}$  $V_{(BR)CEO} > 33\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 30\text{ V}$  $I_{CES} < 10\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 12,5\text{ mJ}$  $R_{BE} = 10\ \Omega$  $E_{SBR} > 12,5\text{ mJ}$ 

D.C. current gain\*

 $I_C = 3,0\text{ A}; V_{CE} = 25\text{ V}$  $h_{FE}$  typ. 50  
15 to 100

Collector-emitter saturation voltage\*

 $I_C = 6,0\text{ A}; I_B = 0,6\text{ A}$  $V_{CEsat}$  typ. 0,75 VTransition frequency at  $f = 100\text{ MHz}^{**}$  $-I_E = 3,0\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 680 MHz $-I_E = 6,0\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 750 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 25\text{ V}$  $C_C$  typ. 155 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 50\text{ mA}; V_{CE} = 25\text{ V}$  $C_{re}$  typ. 88 pF

Collector-flange capacitance

 $C_{cf}$  typ. 3 pF\* Measured under pulse conditions:  $t_p \leq 300\ \mu\text{s}; \delta \leq 0,02$ .\*\* Measured under pulse conditions:  $t_p \leq 50\ \mu\text{s}; \delta \leq 0,01$ .

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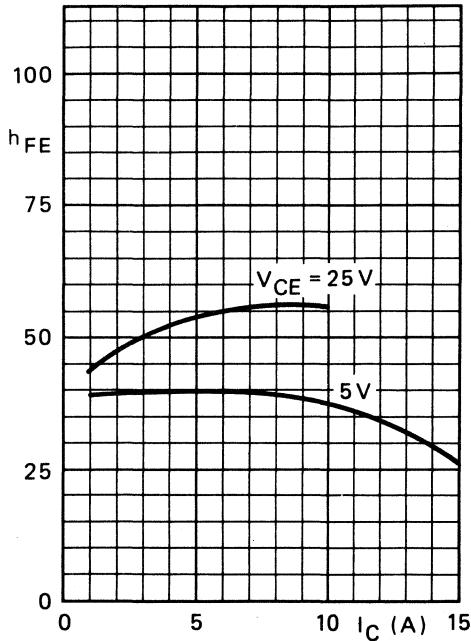


Fig. 5 Typical values;  $T_j = 25^\circ\text{C}$ .

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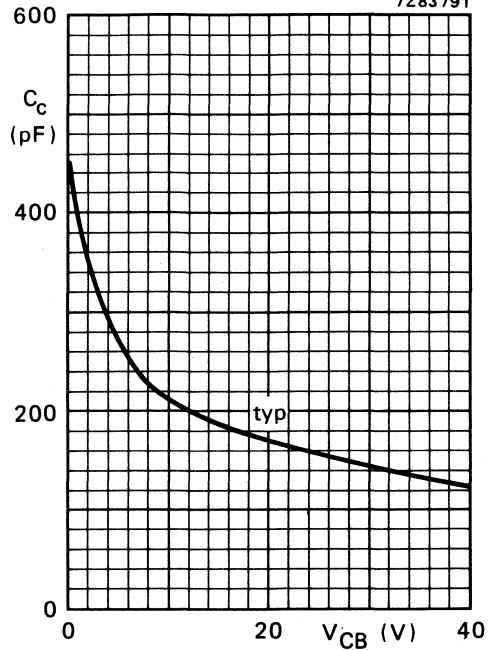


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

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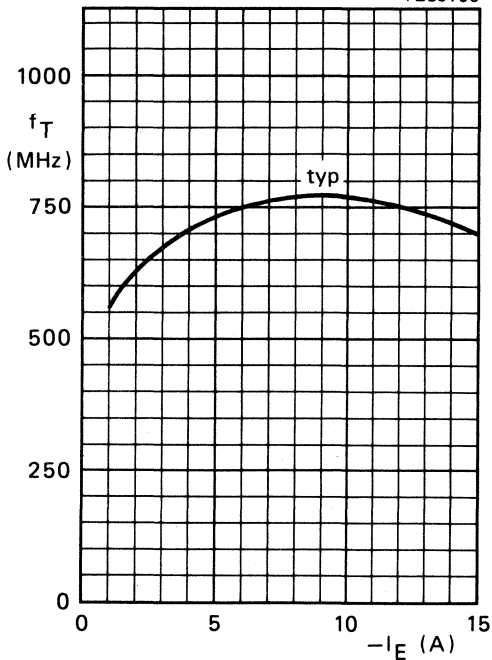


Fig. 7  $V_{CB} = 25\text{ V}$ ;  $f = 100\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

7Z83797

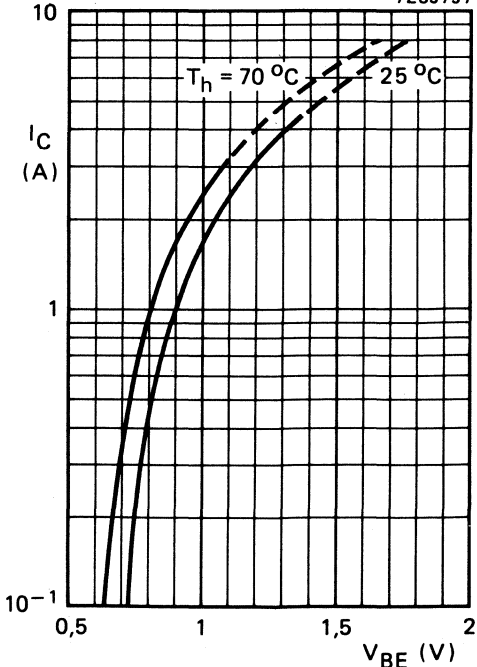


Fig. 8 Typical values;  $V_{CE} = 25\text{ V}$ .

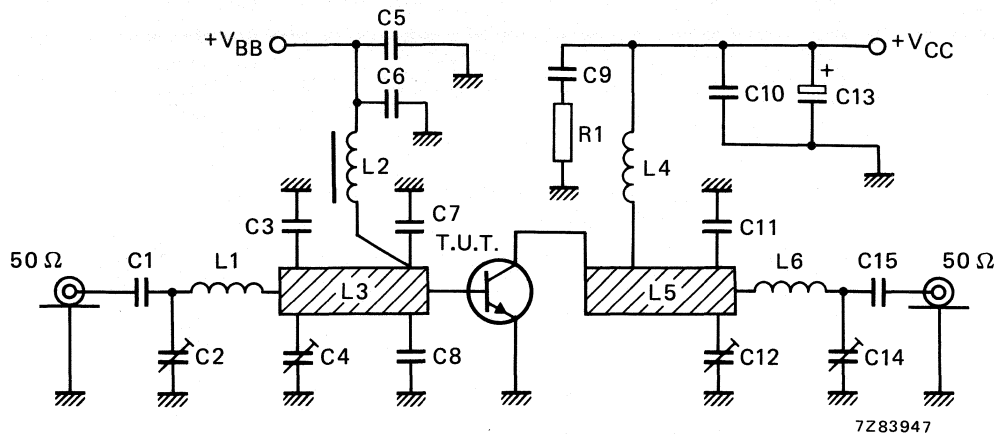


## APPLICATION INFORMATION

R.F. performance in v.h.f. class-A operation (linear power amplifier)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (A)	$T_{\text{h}}$ (°C)	$d_{\text{im}}$ (dB)*	$P_{\text{o sync}}$ (W)*	$G_{\text{p}}$ (dB)
224,25	25	3,2	70	-55	> 16	> 13,5
			70	-55	typ. 17,5	typ. 14,5
			70	-52	typ. 22	typ. 14,5
			25	-55	typ. 22	typ. 14,8

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

Fig. 9 Class-A test circuit at  $f_{\text{vision}} = 224,25$  MHz.

## List of components:

C1 = C15 = 560 pF (500 V) multilayer ceramic chip capacitor (ATC ▲)

C2 = C4 = C12 = C14 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 08002)

C3 = 10 pF (500 V) multilayer ceramic chip capacitor (ATC ▲)

C5 = 470 nF (50 V) multilayer ceramic chip capacitor (cat. no. 2222 856 48474)

C6 = C10 = 680 pF (50 V) multilayer ceramic chip capacitor (cat. no. 2222 852 13681)

C7 = C8 = 47 pF (500 V) multilayer ceramic chip capacitor (ATC ▲); placed 8 mm from transistor edge

C9 = 330 nF polyester capacitor

C11 = 68 pF (500 V) multilayer ceramic chip capacitor (ATC ▲)

C13 = 6,8  $\mu$ F/35 V solid tantalum capacitor

L1 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 5,0 mm; length 5,0 mm; leads 2 x 3 mm

L2 = 1  $\mu$ H microchoke (cat. no. 4322 057 01080)L3 = 30  $\Omega$  stripline (6,0 mm x 32,7 mm)

L4 = 2 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 5,0 mm; leads 2 x 10 mm

L5 = 30  $\Omega$  stripline (6,0 mm x 24,0 mm)

L6 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,0 mm; length 4,5 mm; leads 2 x 3 mm

L3 and L5 are striplines on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric ( $\epsilon_r \approx 4,5$ ); thickness 1/16".R1 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 224,25 MHz class-A test circuit are shown in Fig. 10.

▲ ATC means American Technical Ceramics.

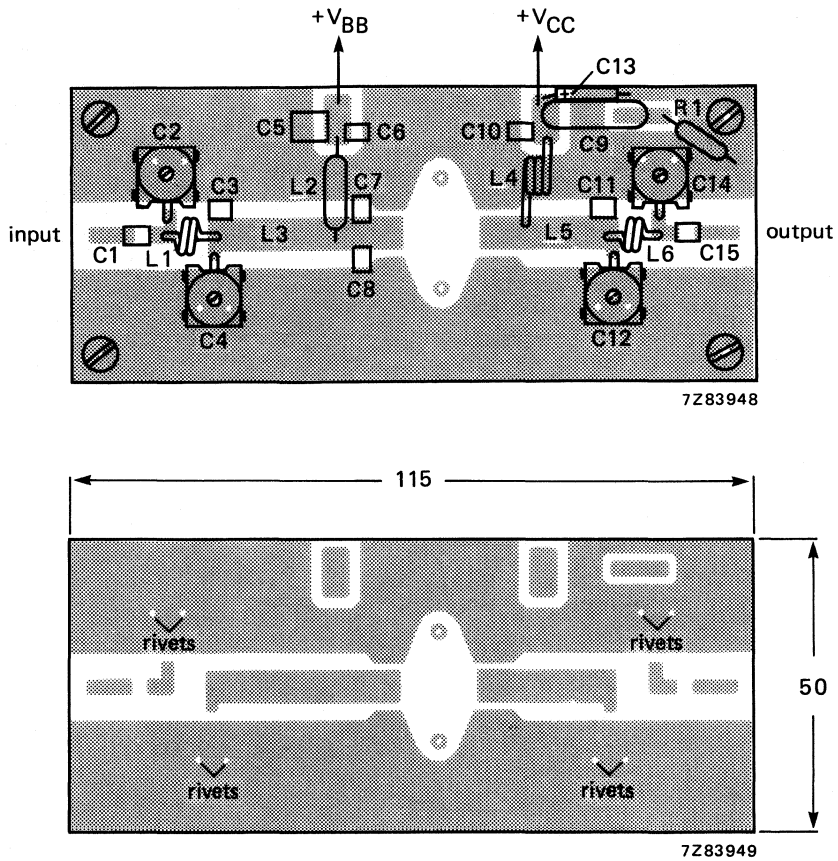


Fig. 10 Component layout and printed-circuit board for 224,25 MHz class-A test circuit.

The circuit and the components are on one side of the epoxy fibre-glass board, the other side is unetched copper to serve as earth. Earth connections are made by hollow rivets. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.

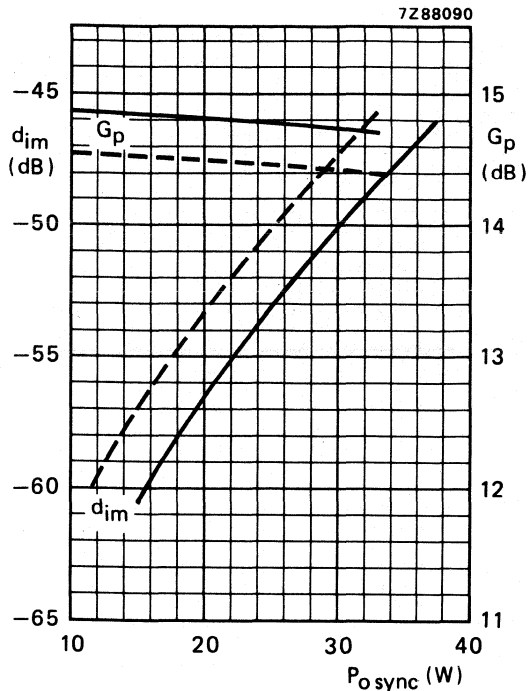


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and power gain as a function of output power.

Conditions for Figs 11 and 12:

Typical values;  $V_{CE} = 25$  V;  $I_C = 3,2$  A; —  $T_h = 25$  °C; - - -  $T_h = 70$  °C;  $f_{vision} = 224,25$  MHz.

#### Ruggedness in class-A operation

The BLV33F is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 30 W (r.m.s. value) or 40 W (P.E.P.) under the following conditions:

$V_{CE} = 25$  V;  $I_C = 3,2$  A;  $T_h = 70$  °C;  $f = 224,25$  MHz;  $R_{th\ mb-h} = 0,2$  K/W.

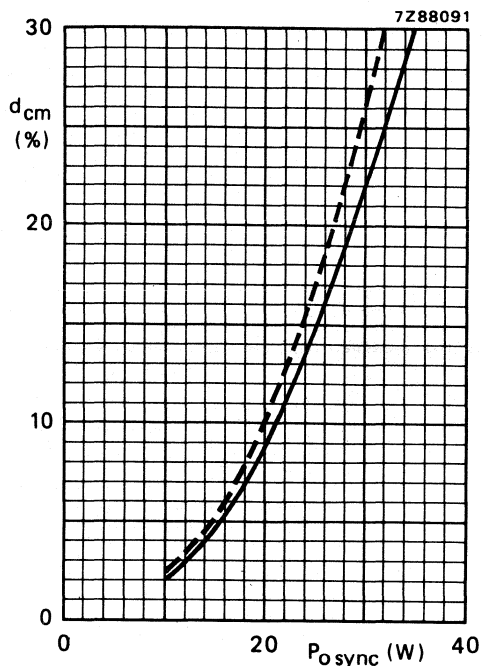


Fig. 12 Cross-modulation distortion ( $d_{cm}$ )\*\* as a function of output power.

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

Intermodulation distortion of input signal  $\leq -70$  dB.

\*\* Two-tone test method (vision carrier 0 dB, sound carrier -7 dB), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from 0 dB to -20 dB.

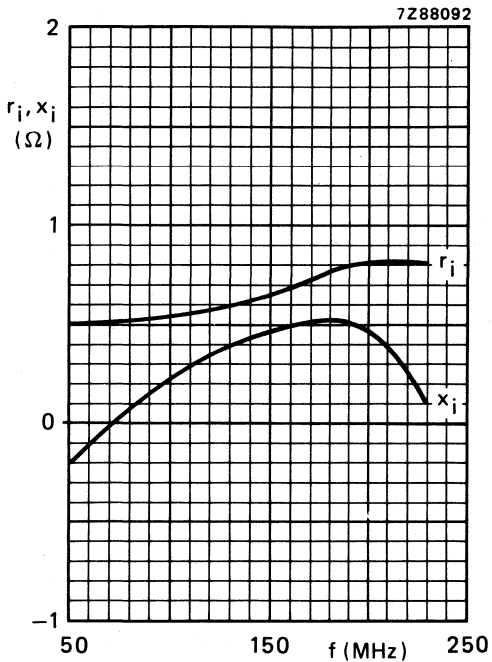


Fig. 13 Input impedance (series components).

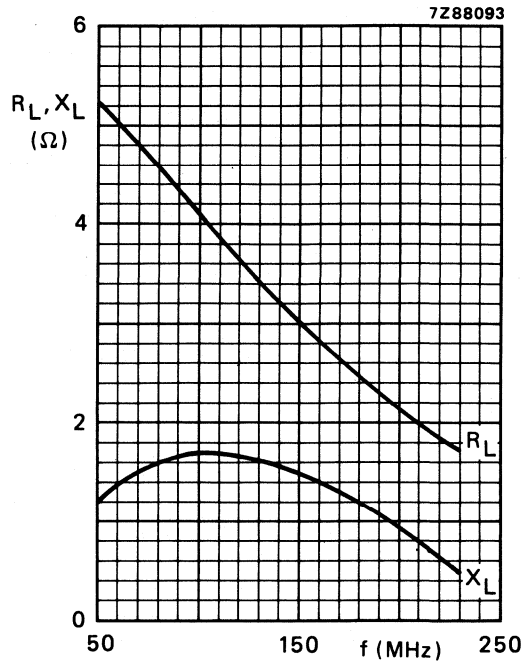


Fig. 14 Load impedance (series components).

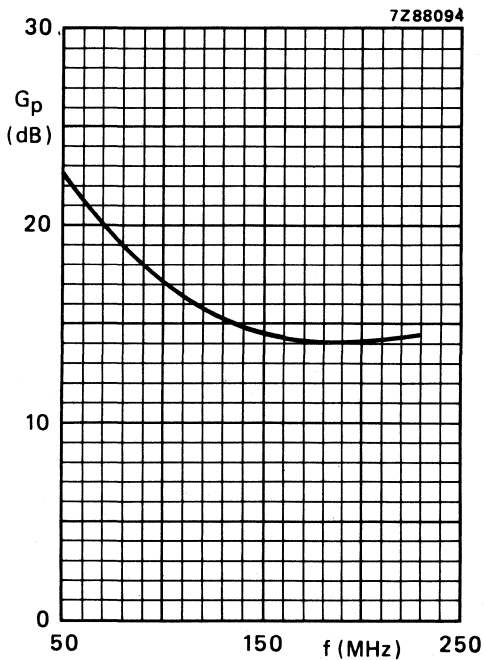


Fig. 15.

Conditions for Figs 13, 14 and 15:

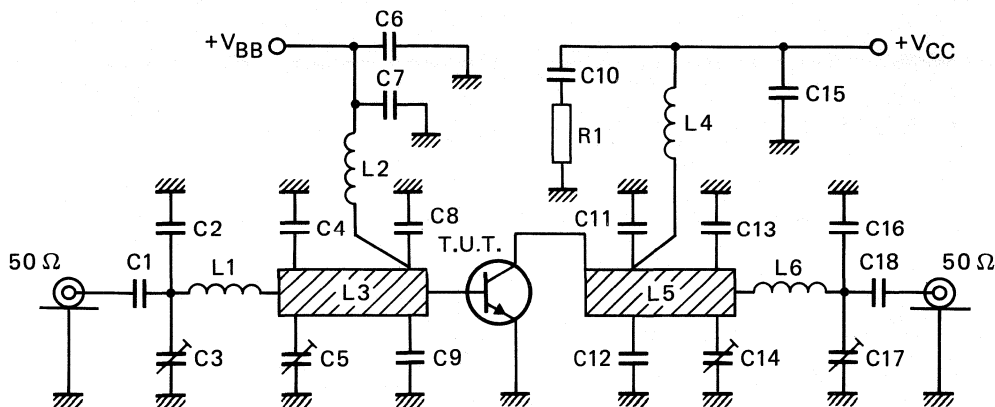
Typical values;  $V_{CE} = 25$  V;  $I_C = 3,2$  A;  
class-A operation;  $T_h = 70$  °C.

## APPLICATION INFORMATION

R.F. performance in v.h.f. class-AB operation (c.w.)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}(Z_{\text{S}})$ (A)	$T_{\text{h}}$ (°C)	$P_{\text{L}}$ (W)	$I_{\text{C}}$ (A)	$\eta$ (%)	$G_{\text{p}}$ (dB)*
224,25	28	0,2	70	40 85	typ. 2,75 typ. 4,25	typ. 52 typ. 71	typ. 11,5 typ. 10,5

\* Gain compression point of 1 dB is at typical 85 W (minimum 75 W). Using a 3rd-order amplitude transfer characteristic, 1 dB compression corresponds with 30% sync input/25% sync output compression in television service (negative modulation, C.C.I.R. system).

Fig. 16 Class-AB test circuit at  $f_{\text{vision}} = 224,25$  MHz.

7Z83946

List of components (component layout and p.c.b. class-AB test circuit see Fig. 17):

- C1 = C18 = 620 pF (100 V) multilayer ceramic chip capacitor (ATC ▲)
- C2 = 27 pF (500 V) multilayer ceramic chip capacitor (ATC ▲)
- C3 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)
- C4 = 30 pF (500 V) multilayer ceramic chip capacitor (ATC ▲)
- C5 = C14 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 08002)
- C6 = C10 = 470 nF (50 V) multilayer ceramic chip capacitor (cat. no. 2222 856 48474)
- C7 = C15 = 680 pF (50 V) multilayer ceramic chip capacitor (2222 852 13681)
- C8 = C9 = 68 pF (500 V) multilayer ceramic chip capacitor (ATC ▲); placed 6,4 mm from transistor edge
- C11 = C12 = 43 pF (500 V) multilayer ceramic chip capacitor (ATC ▲); placed 10 mm from transistor edge
- C13 = 39 pF (500 V) multilayer ceramic chip capacitor (ATC ▲)
- C16 = 3,3 pF (500 V) multilayer ceramic chip capacitor (ATC ▲)
- C17 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- L1 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,5 mm; length 4,0 mm; leads 2 x 4 mm
- L2 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 5,0 mm; leads 2 x 7 mm
- L3 = 30  $\Omega$  stripline (6,0 mm x 47,8 mm)
- L4 = 2 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 5,0 mm; leads 2 x 8 mm
- L5 = 30  $\Omega$  stripline (6,0 mm x 42,9 mm)
- L6 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,0 mm; length 4,0 mm; leads 2 x 3 mm
- L3 and L5 are striplines on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric ( $\epsilon_r \approx 4,5$ ); thickness 1/16".
- R1 = 10  $\Omega$  carbon resistor

▲ ATC means American Technical Ceramics.

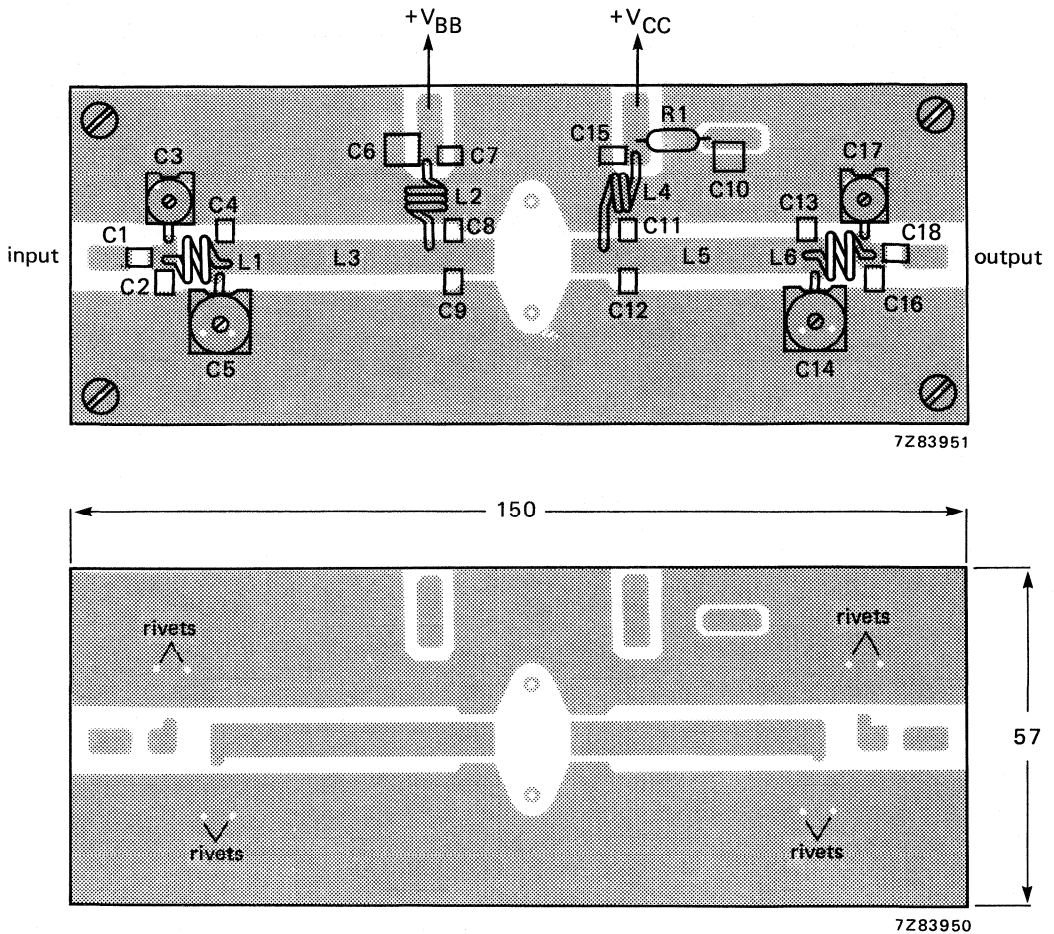


Fig. 17 Component layout and printed-circuit board for 224,25 MHz class-AB test circuit.

The circuit and the components are on one side of the epoxy fibre-glass board, the other side is unetched copper to serve as earth. Earth connections are made by hollow rivets. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.

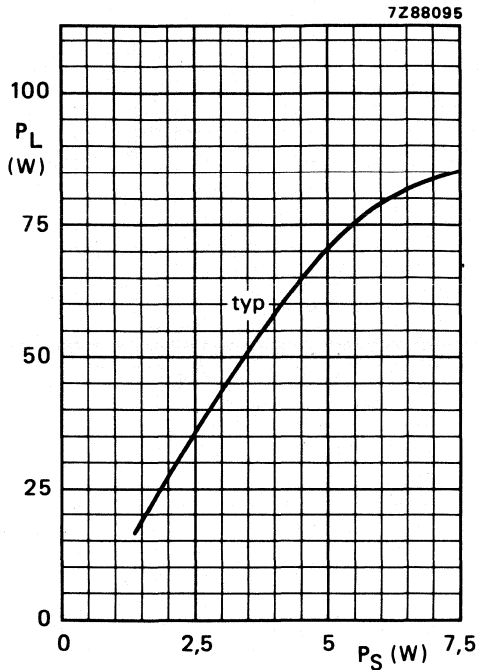


Fig. 18  $V_{CE} = 28$  V;  $I_{C(ZS)} = 0,2$  A;  $T_h = 70$  °C;  $f_{\text{vision}} = 224,25$  MHz.

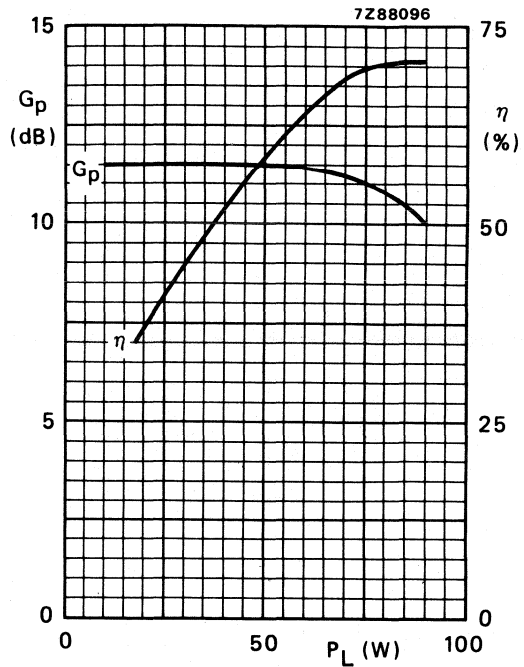


Fig. 19  $V_{CE} = 28$  V;  $I_{C(ZS)} = 0,2$  A;  $T_h = 70$  °C;  $f_{\text{vision}} = 224,25$  MHz; typical values.

**Ruggedness in class-AB operation**

The BLV33F is capable of withstanding a load mismatch ( $V_{\text{SWR}} \leq 2$  through all phases) up to 60 W (r.m.s. value) and 85 W (P.E.P.) under the following conditions:  
 $V_{CE} = 28$  V;  $T_h = 70$  °C;  $f = 224,25$  MHz;  $R_{\text{th mb-h}} = 0,2$  K/W.

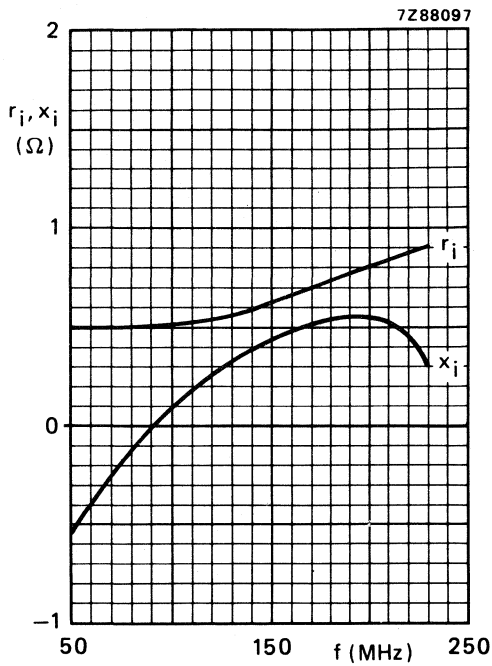


Fig. 20 Input impedance (series components).

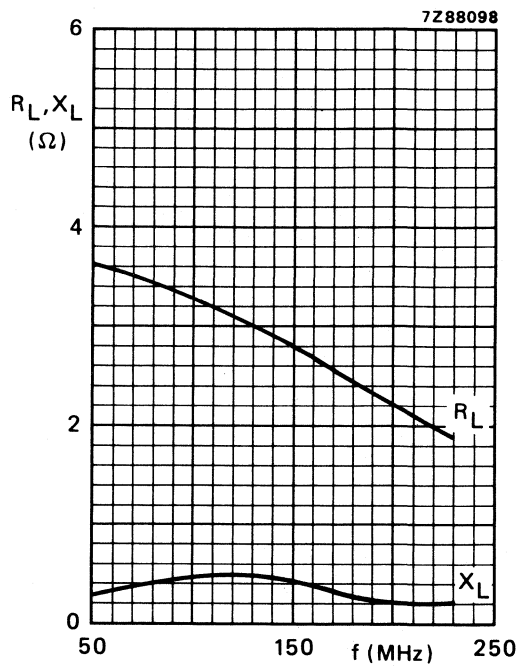


Fig. 21 Load impedance (series components).

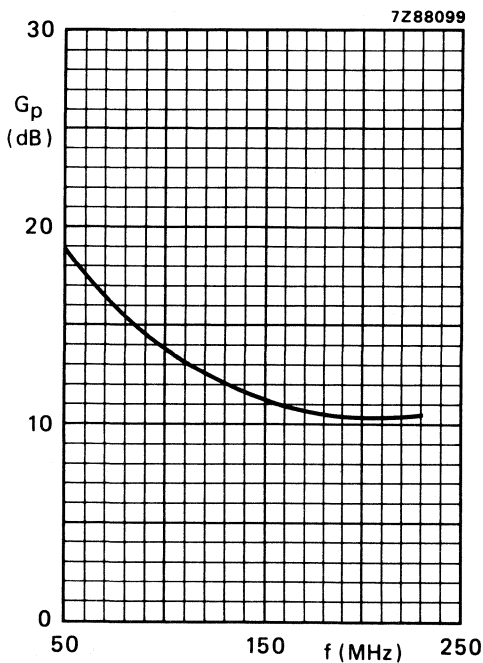


Fig. 22.

Conditions for Figs 20, 21 and 22:  
 Typical values;  $V_{CE} = 28$  V;  $P_L = 80$  W (P.E.P.);  
 class-AB operation;  $T_h = 70$  °C.



## VHF LINEAR PUSH-PULL POWER TRANSISTOR

Two NPN silicon planar epitaxial transistor sections in one envelope to be used as a push-pull amplifier. This device is primarily intended for use in linear VHF television transmitters and transposers (vision or sound amplifier).

### Features

- Internally matched input for wideband operation and high power gain
- Internal midpoint (RF ground) reduces negative feedback and improves power gain
- Increased input and output impedance (compared with single-ended transistors) simplify wideband matching
- Length of external emitter leads is not critical
- Diffused emitter balancing resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability

The envelope is an 8-lead flange type with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

RF performance in push-pull amplifier

mode of operation	V <sub>CE</sub> V	I <sub>C</sub> (ZS) A	f MHz	P <sub>L</sub> W	T <sub>h</sub> °C	G <sub>p</sub> dB	η <sub>c</sub> %	gain compression dB
CW; class-AB	28	2 × 0.25	224.25	115	25	≥ 11.0 typ. 13.0	≥ 48 typ. 55	≤ 1.0*

\* Assuming a 3rd order amplitude transfer characteristic, 1 dB gain compression corresponds with 30% sync input/25% sync output compression in television service (negative modulation, CCIR system).

### MECHANICAL DATA

SOT161 (see Fig.1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

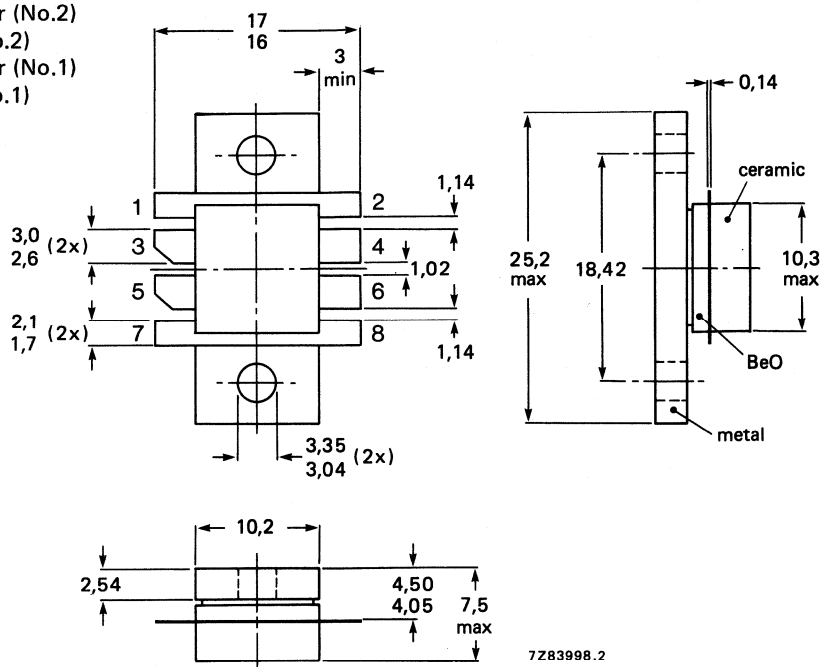
**MECHANICAL DATA**

Dimensions in mm

Fig.1 SOT161.

**Pinning**

- 1 Emitter
- 2 Emitter
- 3 Collector (No.2)
- 4 Base (No.2)
- 5 Collector (No.1)
- 6 Base (No.1)
- 7 Emitter
- 8 Emitter



7Z83998.2

Torque on screw: min. 0.60 Nm  
max. 0.75 Nm

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be sparingly applied and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak value);  
(peak value);  $V_{BE} = 0$

$V_{CESM}$  max. 65 V

open base

$V_{CEO}$  max. 33 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current per transistor section  
DC or average

$I_C, I_{C(AV)}$  max. 8.5 A

(peak value);  $f > 1$  MHz

$I_{CM}$  max. 17.5 A

Total DC power dissipation;  $T_{mb} = 25$  °C

$P_{tot}(DC)$  max. 218 W\*

RF power dissipation

$P_{tot}(RF)$  max. 270 W\*

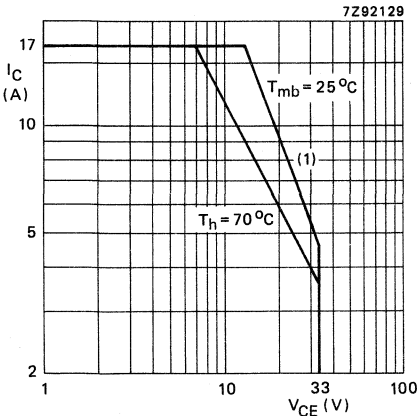
$f > 1$  MHz;  $T_{mb} = 25$  °C

Storage temperature range

$T_{stg}$  -65 to +150 °C

Operating junction temperature

$T_j$  max. 200 °C

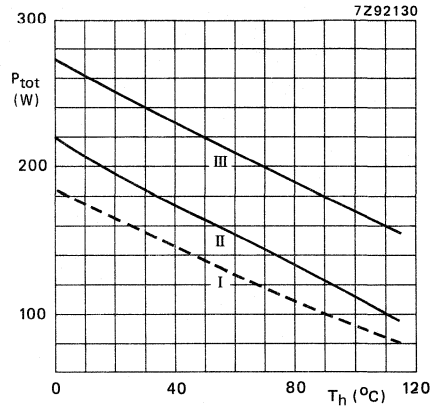


(1) Second breakdown limit.

Fig.2 DC SOAR.

Conditions for Figs 2 and 3:

$R_{th\ mb-h} = 0.25$  K/W; Total device\*.



- I Continuous DC operation
- II Continuous RF operation; ( $f > 1$  MHz)
- III Short-time operation during mismatch; ( $f > 1$  MHz)

Fig.3 Power/temperature derating curves.

**THERMAL RESISTANCE**

(dissipation = 180 W;  $T_{mb} = 25$  °C)\*\*

From junction to mounting base  
(DC dissipation)

$R_{th\ j-mb}(DC) = 0.85$  K/W

From junction to mounting base  
(RF dissipation)

$R_{th\ j-mb}(RF) = 0.64$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0.25$  K/W

\* Dissipation of either transistor section shall not exceed half rated power.

\*\* Both transistor sections equally loaded.

## CHARACTERISTICS

Apply to either transistor section unless otherwise specified.  $T_j = 25\text{ }^\circ\text{C}$ .

Collector-emitter breakdown voltage

$$V_{BE} = 0; I_C = 25\text{ mA}$$

$$V_{(BR)CES} > 65\text{ V}$$

$$\text{open base; } I_C = 100\text{ mA}$$

$$V_{(BR)CEO} > 33\text{ V}$$

Emitter-base breakdown voltage

$$\text{open collector; } I_E = 10\text{ mA}$$

$$V_{(BR)EBO} > 4\text{ V}$$

Collector cut-off current

$$V_{BE} = 0; V_{CE} = 33\text{ V}$$

$$I_{CES} < 10\text{ mA}$$

Second-breakdown energy;  $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$

$$R_{BE} = 10\ \Omega$$

$$E_{SBR} > 10\text{ mJ}$$

DC current gain\*

$$I_C = 3.5\text{ A; } V_{CE} = 25\text{ V}$$

$$h_{FE} \begin{array}{l} \text{typ.} \\ 15 \text{ to} \end{array} \begin{array}{l} 45 \\ 100 \end{array}$$

Transition frequency at  $f = 100\text{ MHz}$ \*

$$-I_E = 3.3\text{ A; } V_{CB} = 25\text{ V}$$

$$f_T \text{ typ. } 575\text{ MHz}$$

$$-I_E = 10\text{ A; } V_{CB} = 25\text{ V}$$

$$f_T \text{ typ. } 600\text{ MHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = i_e = 0; V_{CB} = 25\text{ V}$$

$$C_c \text{ typ. } 155\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 50\text{ mA; } V_{CE} = 25\text{ V}$$

$$C_{re} \text{ typ. } 88\text{ pF}$$

Collector-flange capacitance

$$C_{cf} \text{ typ. } 2\text{ pF}$$

\* Measured under pulse conditions:  $t_p \leq 300\ \mu\text{s}$ ;  $\delta \leq 0.02$ .

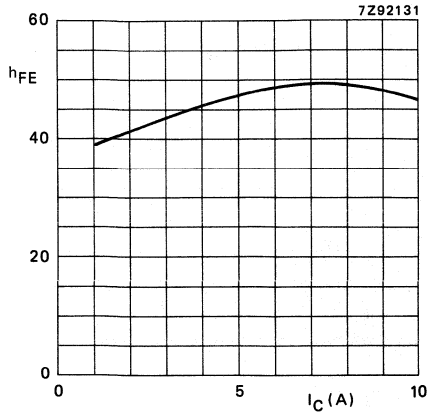


Fig.4 DC current gain as a function of collector current;  $V_{CE} = 25$  V;  $T_j = 25$  °C; typical values.

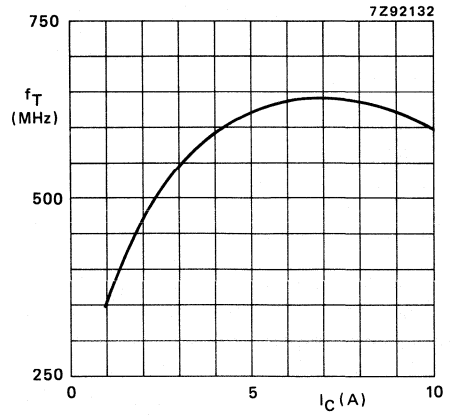


Fig.5 Transition frequency as a function of collector current;  $V_{CE} = 25$  V;  $f = 100$  MHz;  $T_j = 25$  °C; typical values.

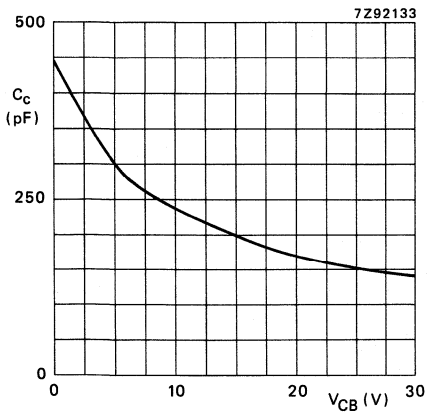


Fig.6 Collector capacitance as a function of collector-base voltage;  $I_E = i_e = 0$ ;  $f = 1$  MHz; typical values.

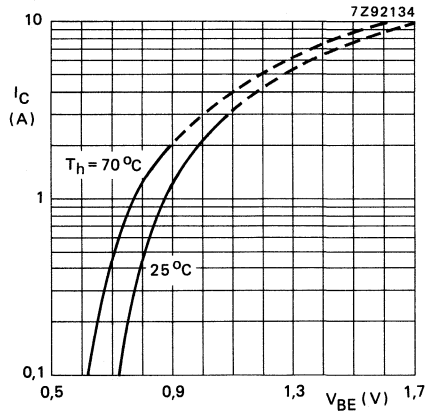


Fig.7 Collector current as a function of base-emitter voltage;  $V_{CE} = 25$  V; typical values.

The above graphs apply to either transistor section.

## APPLICATION INFORMATION

RF performance in VHF class-AB operation (linear push-pull power amplifier)  $V_{CE} = 28 \text{ V}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ ;  $f = 224.25 \text{ MHz}$ .

mode of operation	$P_L$ W	$I_{C(ZS)}$ A	$G_p$ dB	$\eta_C$ %	gain compression dB
class-AB; CW	115	$2 \times 0.15$	$\geq 11.0$ typ. 13.0	$\geq 48$ typ. 55	$\leq 1.0^*$ typ. 0.5*

\* Assuming a 3rd order amplitude transfer characteristic, 1 dB gain compression corresponds with 30% sync input/25% sync output compression in television service (negative modulation, C.C.I.R. system).

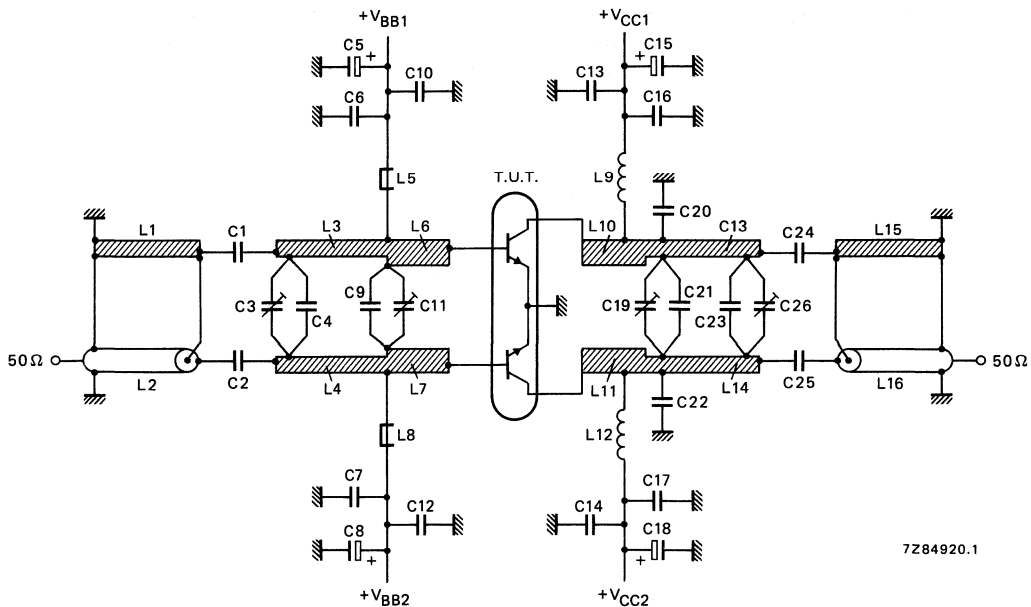


Fig.8 Class-AB test circuit at 224.25 MHz.

## List of components:

- C1 = C2 = C24 = C25 = 68 pF (500 V) multilayer ceramic chip capacitor.\*\*
  - C3 = C11 = C26 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 08002).
  - C4 = 33 pF (500 V) multilayer ceramic chip capacitor.\*\*
  - C5 = C8 = 4.7  $\mu\text{F}$  (63 V) electrolytic capacitor.
  - C6 = C7 = C16 = C17 = 100 nF multilayer ceramic chip capacitor (cat. no. 2222 855 48104).
  - C9 = 2 x 47 pF (500 V) multilayer ceramic chip capacitors in parallel.\*\*
  - C10 = C12 = C13 = C14 = 470 pF multilayer ceramic chip capacitor (cat. no. 2222 852 13471).
  - C15 = C18 = 10  $\mu\text{F}$  (63 V) electrolytic capacitor.
  - C19 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 05003).
  - C20 = C22 = 3.3 pF (500 V) multilayer ceramic chip capacitor.\*\*
  - C21 = parallel connection of 2 x 27 pF (500 V) ceramic chip capacitors.\*\*
  - C23 = 5.6 pF (500 V) multilayer ceramic chip capacitor.\*\*
- (C9 and C11 are connected 11 mm from transistor edge and C19 and C21 18 mm from transistor edge.)

\*\* American Technical Ceramics capacitor type 100A or capacitor of same quality.

L1 = L15 = 50  $\Omega$  stripline (2.8 mm x 91.3 mm).

L2 = L16 = 50  $\Omega$  semi-rigid cable; outer diameter 2.2 mm; outer conductor length 91.3 mm.

L3 = L4 = L13 = L14 = 60  $\Omega$  stripline (2.0 mm x 27.9 mm).

L5 = L8 = 100 nH microchoke.

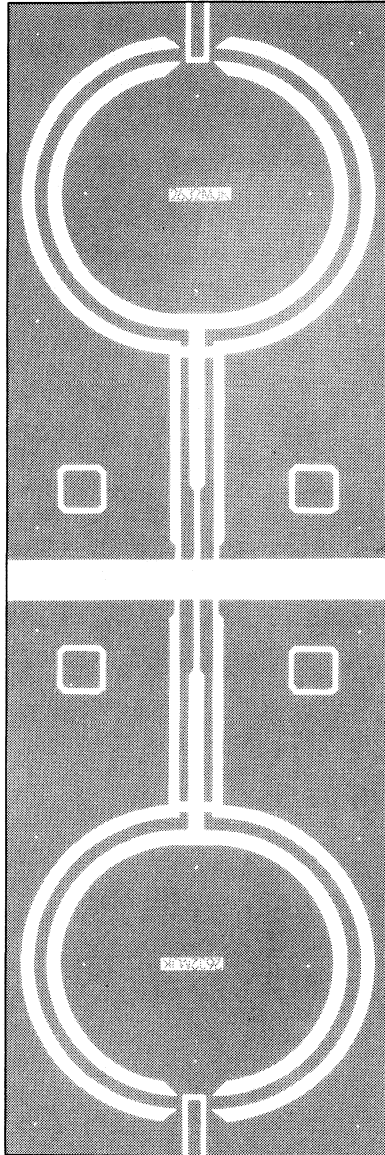
L6 = L7 = L10 = L11 = 48  $\Omega$  stripline (3.0 mm x 14.6 mm).

L9 = L12 = 20.5 nH; 2 turns enamelled Cu wire (1.0 mm); int. dia. 4.5 mm; length 3 mm; leads  
2 x 10 mm; connected 15 mm from transistor edge.

L1, L3, L4, L6, L7, L10, L11, L13, L14 and L15 are striplines on a double Cu-clad printed circuit board with epoxy fibre-glass dielectric ( $\epsilon_r = 4.5$ ); thickness 1/16 inch.

The printed circuit board and component layout for a 224.25 MHz, class-AB test are given in Fig. 9 and Fig. 10 respectively.

The circuit and the components are on one side of the epoxy fibre-glass board; the other side is unetched copper to serve as ground plane. Earth connections are made by hollow rivets and in addition by fixing screws and also by copper straps under the emitters and at the input and output.



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Fig. 9 Printed circuit board for 224.25 MHz class-AB test circuit.



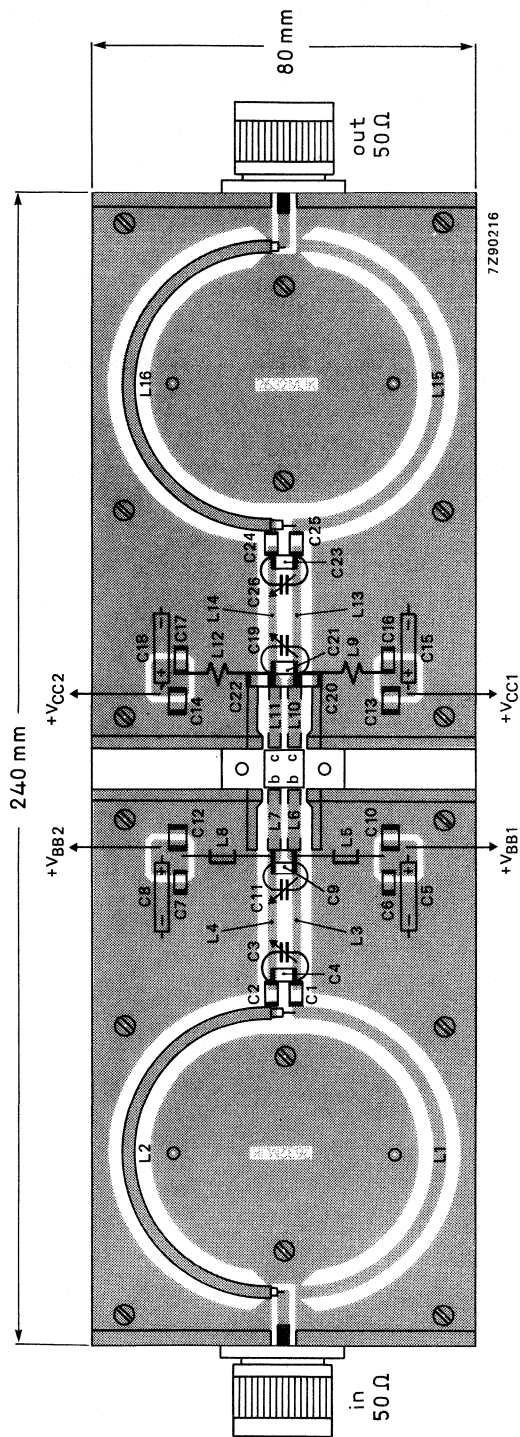


Fig. 10 Component layout of a 224.25 MHz class-AB test circuit.

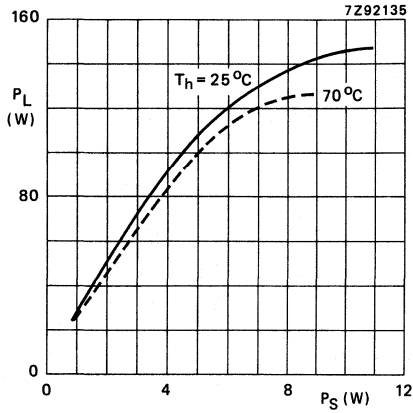


Fig.11 Load power as a function of source power; typical values.

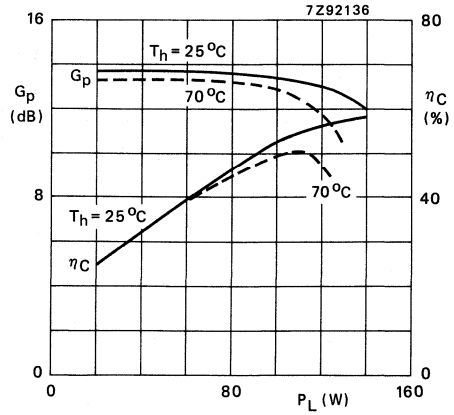


Fig.12 Power gain and efficiency as functions of load power; typical values.

Conditions for Figs 11 and 12:

$V_{CE} = 28\text{ V}$ ;  $I_{C(ZS)} = 2 \times 0.15\text{ A}$ ;  $f = 224.25\text{ MHz}$ ; class-AB.

**RUGGEDNESS**

The BLV36 is capable of continuously withstanding a load mismatch (VSWR = 5, through all phases) up to 80 W under the following conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 2 \times 0.15 \text{ A}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f = 224.25 \text{ MHz}$ ;  $R_{th \text{ mb-h}} = 0.25 \text{ K/W}$ .

The instantaneous collector current should not exceed 10 A.

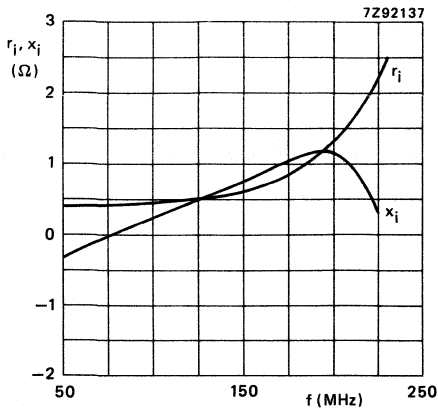


Fig.13 Input impedance (series components) as a function of frequency; typical values.

Conditions for Figs 13, 14 and 15:

The graphs apply to either transistor section assuming class-AB push-pull operation

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 0.15 \text{ A}$ ;  $P_L = 70 \text{ W}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ .

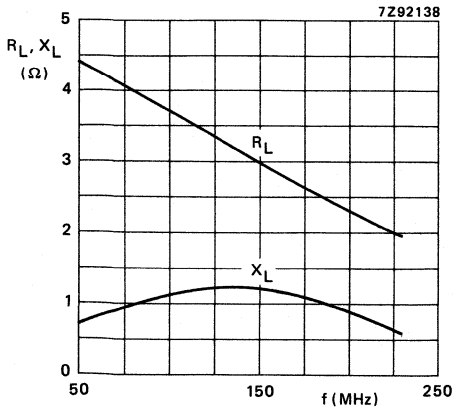


Fig.14 Load impedance (series components) as a function of frequency; typical values.

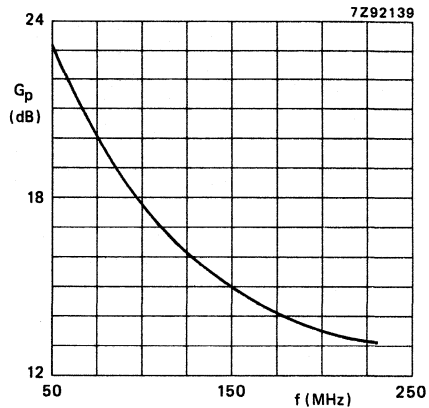


Fig.15 Power gain as a function of frequency; typical values.



# DEVELOPMENT DATA

This data sheet contains advance information and specifications are subject to change without notice.

BLV37

## VHF PUSH-PULL POWER TRANSISTOR

Push-pull npn silicon planar epitaxial transistor primarily intended for use in VHF broadcast transmitters.

### Features:

- internally matched input for wideband operation and high power gain;
- implanted emitter ballasting resistors for an optimum temperature profile.
- gold metallization ensures excellent reliability.

The transistor has a 5-lead rectangular flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

RF performance up to  $T_h = 25^\circ\text{C}$  in a common-emitter class-B push-pull test circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; cw	28	108	250	> 10.5	> 60

### MECHANICAL DATA

(See next page).

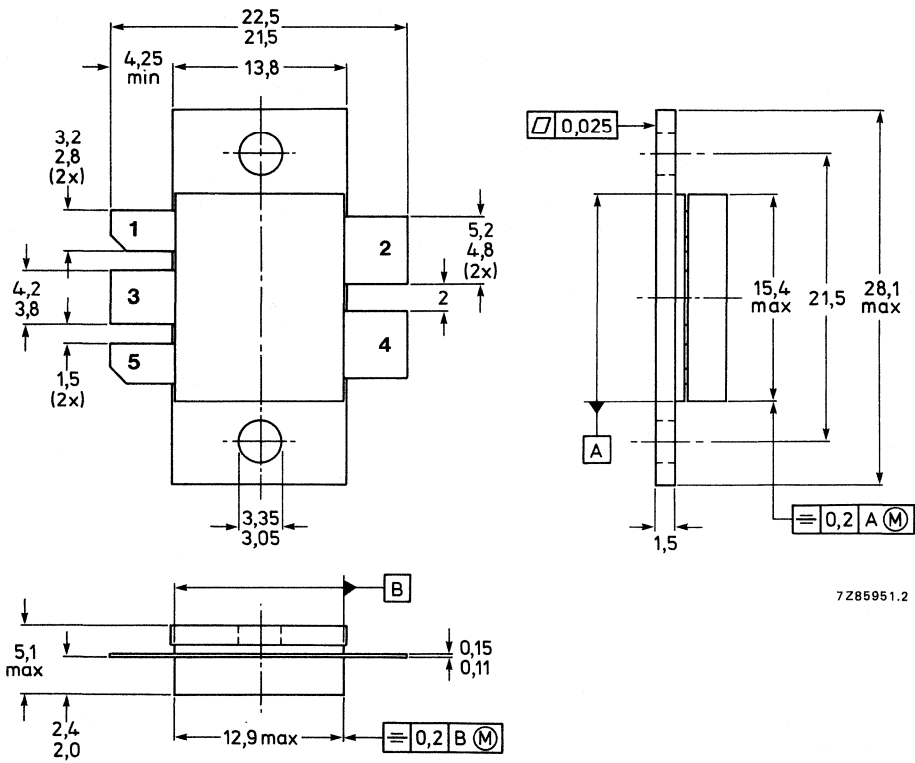
**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Dimensions in mm

Pinning:

- 1 = Collector (No. 2)
- 2 = Base (No. 2)
- 3 = Emitter
- 4 = Base (No. 1)
- 5 = Collector (No. 1)



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Fig. 1 SOT-179.

**RATINGS** (per transistor section)

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage $V_{BE} = 0$ ; peak value	$V_{CESM}$	max.	70 V
Collector-emitter voltage open base	$V_{CEO}$	max.	40 V
Emitter-base voltage open collector	$V_{EBO}$	max.	4.0 V
Collector current DC or average	$I_C$	max.	10 A
peak ( $f > 1$ MHz)	$I_{CM}$	max.	30 A
Total power dissipation (both sections)* $T_{mb} = 25$ °C	$P_{tot}$	max.	290 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

**THERMAL RESISTANCE** (Total device;  $T_{mb} = 25$  °C)

From junction to mounting base (DC dissipation = $2 \times 120$ W; $T_{mb} = 25$ °C)	$R_{th\ j-mb(DC)}$	max.	0.6 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0.2 K/W

**CHARACTERISTICS** (per transistor section) $T_j = 25$  °C unless otherwise specified

Collector-emitter breakdown voltage $V_{BE} = 0$ ; $I_C = 60$ mA	$V_{(BR)CES}$	min.	70 V
Collector-emitter breakdown voltage open base; $I_C = 120$ mA	$V_{(BR)CEO}$	min.	40 V
Emitter-base breakdown voltage open collector; $I_E = 12$ mA	$V_{(BR)EBO}$	min.	4.0 V
Collector cut-off current $V_{CE} = 40$ V; $V_{BE} = 0$	$I_{CES}$	max.	30 mA
DC current gain $I_C = 6$ A; $V_{CE} = 30$ V	$h_{FE}$	min. max.	15 80
DC current gain ratio of transistor sections; $I_C = 6$ A; $V_{CE} = 30$ V			0.67 to 1.5
Collector capacitance at $f = 1$ MHz $I_E = I_e = 0$ ; $V_{CB} = 30$ V	$C_C$	typ.	195 pF

\* Both sections equally loaded

**APPLICATION INFORMATION**

RF performance in cw operation (common-emitter class-B circuit);  $T_h = 25\text{ }^\circ\text{C}$ .

f MHz	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
108	28	250	> 10.5 typ. 11.3	> 60 typ. 70

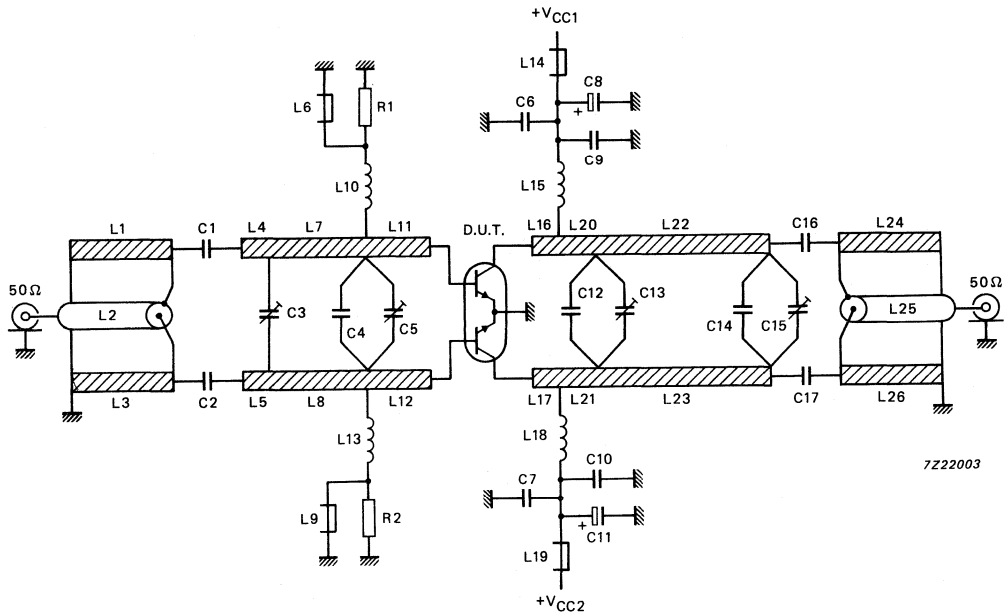


Fig. 2 Class-B test circuit at  $f = 108\text{ MHz}$ .



**List of components**

- C1 = C2 = 1 x 100 pF (500 V) and 1 x 120 pF (500 V) multilayer ceramic chip capacitors in parallel.\*
- C3 = C5 = C13 = C15 = 5 to 60 film dielectric trimmer (cat. no. 2222 809 08003).
- C4 = 2 x 100 pF (500 V) multilayer chip capacitors in parallel.\*
- C6 = C7 = 10 nF (50 V) multilayer ceramic chip capacitor.
- C8 = C11 = 6,8  $\mu$ F (63 V) electrolytic capacitor.
- C9 = C10 = 2 x 470 pF (500 V) multilayer ceramic chip capacitors in parallel. \*
- C12 = 1 x 22 pF (500 V) and 4 x 27 pF (500 V) multilayer ceramic chip capacitors in parallel. \*
- C14 = 14 pF (500 V) multilayer ceramic chip capacitor. \*
- C16 = C17 = 2 x 62 pF (500 V) multilayer ceramic chip capacitors in parallel. \*
- L1 = L3 = L24 = L26 = 50  $\Omega$  stripline (4.8 mm x 163.8 mm).
- L2 = L21 = 50  $\Omega$  semi-rigid cable; outer dia. 3.6 mm; outer conductor length 163.8 mm; soldered on striplines L1 and L24.
- L4 = L5 = 43  $\Omega$  stripline (6.0 mm x 11.5 mm).
- L6 = L9 = Ferroxcube wide-band HF choke; grade 3B (cat. no. 4312 020 36642).
- L7 = L8 = 43  $\Omega$  stripline (6.0 mm x 64.8 mm).
- L10 = L13 = 7 turns closely wound enamelled Cu wire (0.4 mm); int. dia. 3 mm; leads 2 x 5 mm.
- L11 = L12 = 43  $\Omega$  stripline (6.0 mm x 24.3 mm).
- L16 = L17 = 43  $\Omega$  stripline (6.0 mm x 11.0 mm).
- L14 = L19 = 2 x Ferroxcube wide-band HF choke; grade 3B (cat. no. 4312 020 36642) in parallel or modified single choke with 3 straight wires (0.8 mm) through FXC-bead in parallel.
- L15 = L18 = 40 nH; 1 3/4 turns enamelled Cu wire (2.0 mm); int. dia. 10 mm; leads 2 x 7 mm; space 1 mm.
- L20 = L21 = 43  $\Omega$  stripline (6.0 mm x 31.9 mm).
- L22 = L23 = 43  $\Omega$  stripline (6.0 mm x 87.4 mm).
- R1 = R2 = 10  $\Omega$   $\pm$  5%; 1/2 W metal film resistor.

L1, L3, L4, L5, L7, L8, L11, L12, L16, L17, L20, L21, L22, L23, L24 and L26 are striplines on a double Cu-clad printed circuit board with glass microfibre reinforced PTFE dielectric ( $\epsilon_r = 2.2$ ); thickness 1/16 inch; thickness of copper sheet 2 x 35  $\mu$ m.

The circuit and the components are on one side of the pc board, the other side is unetched copper to serve as ground plane. Earth connections are made by copper straps under the emitter and at the input and output. The emitter-lead is also connected to earth by a hollow rivet.

**Ruggedness in class-B operation**

The BLV37 is capable of withstanding a load mismatch (VSWR = 3 through all phases) under the following conditions:

$V_{CE} = 28$  V;  $f = 108$  MHz;  $T_h = 25$  °C;  $P_L = 250$  W.

\* American Technical Ceramics (ATC) capacitor, type 100B or capacitor of same quality.

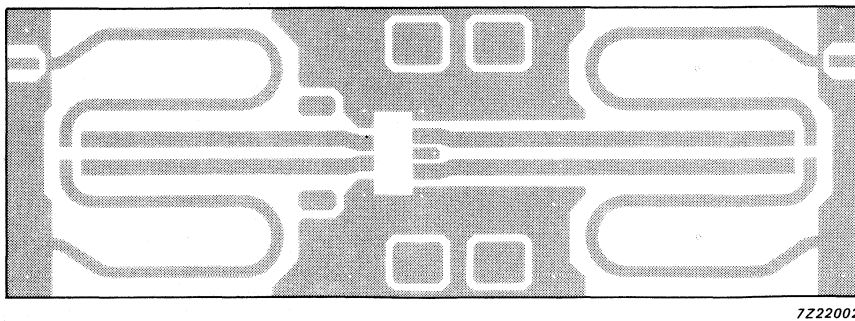
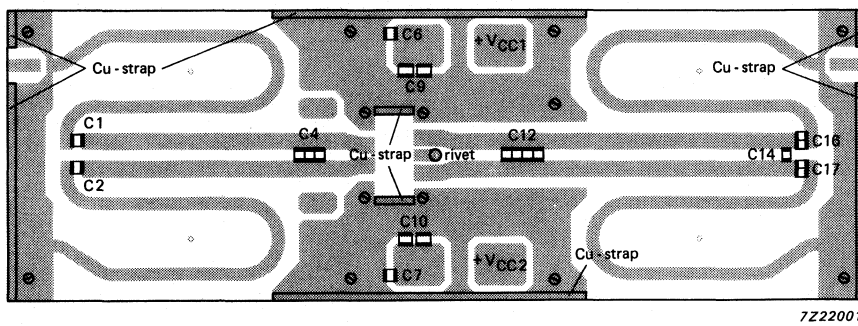
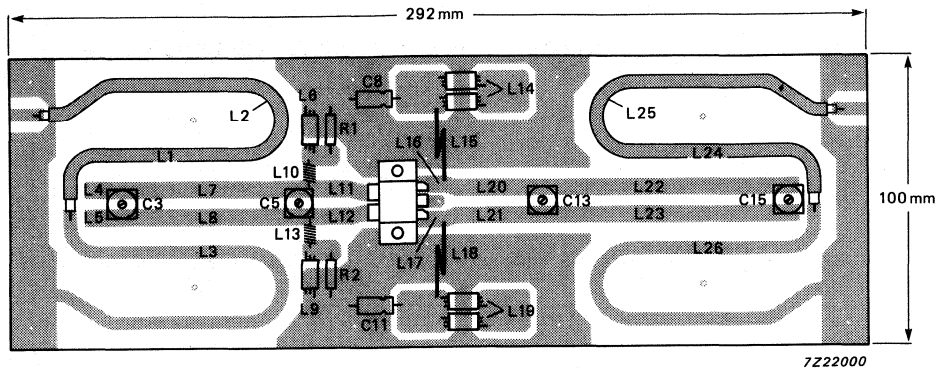


Fig. 3 Component layout and printed-circuit board for 108 MHz test circuit.

## V H F LINEAR PUSH-PULL POWER TRANSISTOR

Push-pull npn silicon planar epitaxial transistor primarily intended for use in VHF television transmitters.

**Features:**

- internally matched input for wideband operation and high power gain;
- implanted emitter ballasting resistors for an optimum temperature profile;
- gold metallization ensures excellent reliability.

The transistor has a 5-lead rectangular flange envelope with a ceramic cap. All leads are isolated from the flange.

**QUICK REFERENCE DATA**

RF performance at  $T_h = 25^\circ\text{C}$  in a common-emitter class-AB push-pull test circuit.

mode of operation	$V_{CE}$ V	$I_C(ZS)$ A	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %	gain compression dB
narrow band; cw; class-AB	35	2 x .200	224.25	225	> 8.0	> 50	$\leq 1.0$ *

\* Assuming a 3<sup>rd</sup> order amplitude transfer characteristic, 1 dB gain compression corresponds with 30% sync input/ 25% sync output compression in television service (negative modulation, CCIR system).

**MECHANICAL DATA**

(See next page).

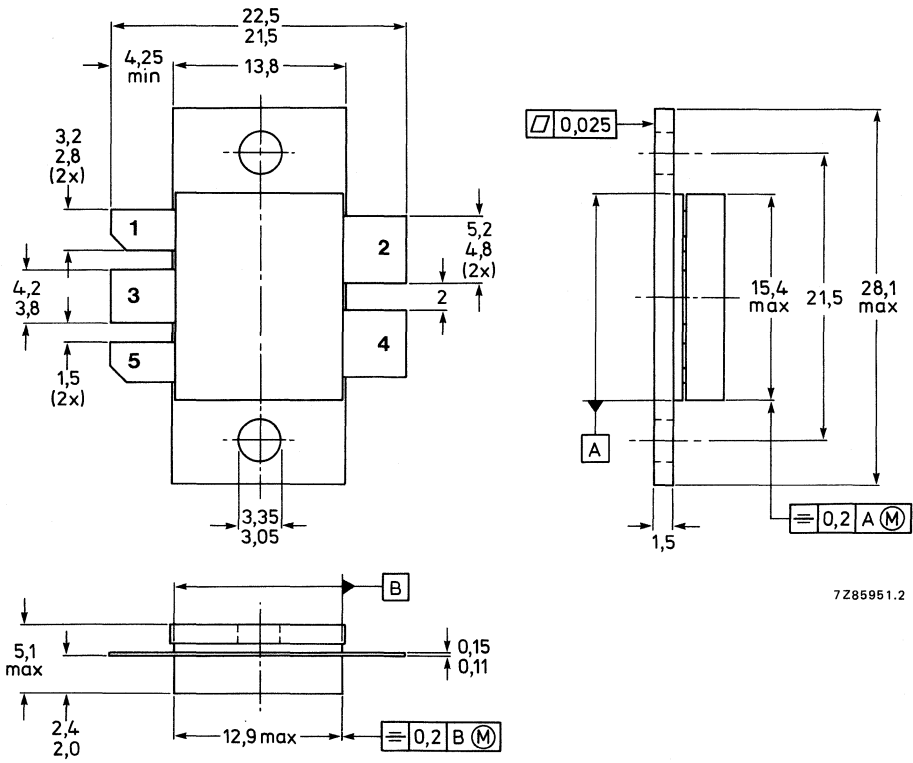
**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Dimensions in mm

Pinning:

- 1 = Collector (No. 2)
- 2 = Base (No. 2)
- 3 = Emitter
- 4 = Base (No. 1)
- 5 = Collector (No. 1)



7285951.2

Fig. 1 SOT-179.

**RATINGS** (per transistor section)

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage $V_{BE} = 0$ ; peak value	$V_{CESM}$	max.	70 V
Collector-emitter voltage open base	$V_{CEO}$	max.	40 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4.0 V
Collector current DC or average	$I_C$	max.	10 A
peak ( $f > 1$ MHz)	$I_{CM}$	max.	25 A
Total power dissipation (both sections)* $T_{mb} = 25$ °C; $f > 1$ MHz	$P_{tot}$	max.	290 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

**THERMAL RESISTANCE** (Total device;  $T_{mb} = 25$  °C)

From junction to mounting base (DC dissipation = $2 \times 120$ W; $T_{mb} = 25$ °C)	$R_{th\ j-mb(DC)}$	max.	0.6 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0.2 K/W

**CHARACTERISTICS** (per transistor section) $T_j = 25$  °C unless otherwise specified

Collector-emitter breakdown voltage $V_{BE} = 0$ ; $I_C = 60$ mA	$V_{(BR)CES}$	min.	70 V
Collector-emitter breakdown voltage open base; $I_C = 120$ mA	$V_{(BR)CEO}$	min.	40 V
Emitter-base breakdown voltage open collector; $I_E = 12$ mA	$V_{(BR)EBO}$	min.	4.0 V
Collector cut-off current $V_{CE} = 40$ V; $V_{BE} = 0$	$I_{CES}$	max.	30 mA
DC current gain $I_C = 6$ A; $V_{CE} = 30$ V	$h_{FE}$	min. max.	15 80
DC current gain ratio of transistor sections: $I_C = 6$ A; $V_{CE} = 30$ V			0.67 to 1.5
Collector capacitance at $f = 1$ MHz $I_E = i_e = 0$ ; $V_{CB} = 30$ V	$C_c$	typ.	195 pF

DEVELOPMENT DATA

\*Both sections equally loaded

**APPLICATION INFORMATION**

RF performance in cw operation (common-emitter class-AB circuit);  $T_h = 25\text{ }^\circ\text{C}$ .

f MHz	$V_{CE}$ V	$P_L$ W	$I_C(ZS)$ A	$G_p$ dB	$\eta_C$ %
224.25	35	225	2 x .200	> 8.0	> 50
		112.5		typ. 8.8	
				> 9.0	typ. 58
				typ. 9.8	

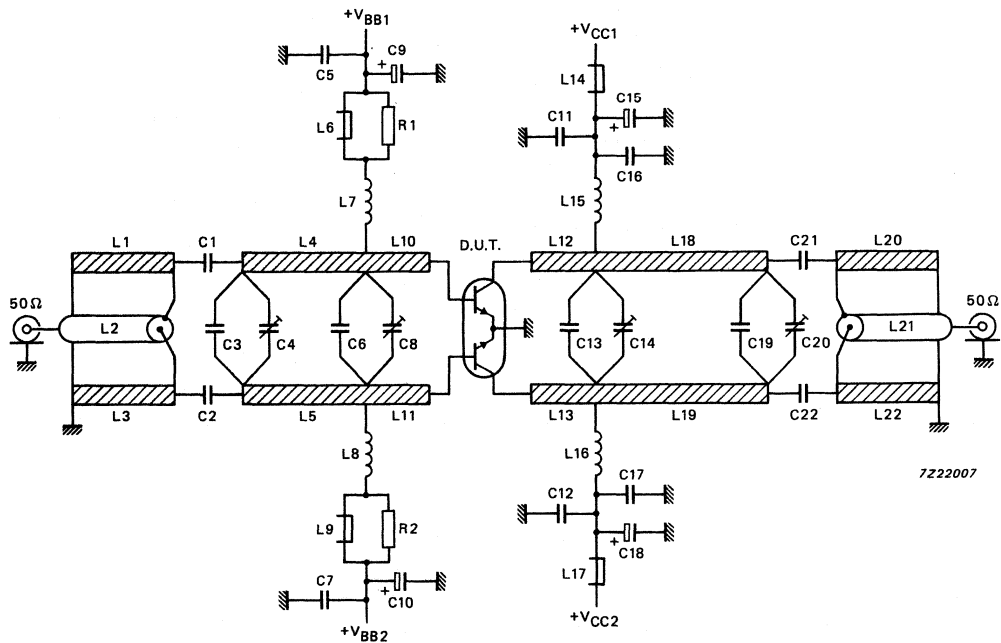


Fig. 2 Class-AB test circuit at  $f = 225\text{ MHz}$ .

**List of components**

- C1 = C2 = C6 = 2 x 27 pF (500 V) multilayer ceramic chip capacitors in parallel. \*  
 C3 = 68 pF (500 V) multilayer ceramic chip capacitor. \*  
 C4 = C20 = 2 to 18 pF film dielectric trimmer. (cat. no. 2222 809 05003).  
 C5 = C7 = 470 pF (500 V)\* and 10 nF (50 V) multilayer ceramic chip capacitors in parallel.  
 C8 = C14 = 4 to 40 pF film dielectric trimmer. (cat. no. 2222 809 08002).  
 C9 = C10 = 4.7  $\mu$ F (63 V) electrolytic capacitor.  
 C11 = C12 = 10 nF (50 V) multilayer ceramic chip capacitor.  
 C13 = 3 x 27 pF (500 V) multilayer ceramic chip capacitors in parallel. \*  
 C15 = C18 = 10  $\mu$ F (63 V) electrolytic capacitor.  
 C16 = C17 = 2 x 470 pF multilayer ceramic chip capacitors in parallel. \*  
 C19 = 3 x 8.2 pF (500 V) multilayer ceramic chip capacitors in parallel. \*  
 C21 = C22 = 3 x 18 pF (500 V) multilayer ceramic chip capacitors in parallel. \*  
 L1 = L3 = L20 = L22 = 50  $\Omega$  stripline (4.8 x 80 mm).  
 L2 = L21 = 50  $\Omega$  semi-rigid cable; outer dia. 3.6 mm; outer conductor length 80 mm; soldered on striplines L1 and L20.  
 L4 = L5 = 43  $\Omega$  stripline (6.0 mm x 37 mm).  
 L6 = L9 = Ferroxcube wide-band HF choke; grade 3B (cat. no. 4312 020 36642).  
 L7 = L8 = 7 turns closely wound enamelled Cu wire (0.4 mm); int. dia. 3 mm; leads 2 x 5 mm.  
 L10 = L11 = 43  $\Omega$  stripline (6.0 mm x 15.8 mm).  
 L12 = L13 = 43  $\Omega$  stripline (6.0 mm x 11.4 mm).  
 L14 = L17 = Ferroxcube wide-band HF choke; grade 3B (cat. no. 4312 020 36642), 3 straight wires (0.8 mm) through FXC-bead in parallel.  
 L15 = L16 = 30 nH; 2 turns enamelled Cu wire (1.6 mm); int. dia. 6 mm; leads 2 x 6 mm; coil length 5 mm; connected 10 mm from transistor edge.  
 L18 = L19 = 43  $\Omega$  stripline (6.0 mm x 34.6 mm).  
 R1 = R2 = 10  $\Omega$   $\pm$  5%; 1/2 W metal film resistor.

DEVELOPMENT DATA

L1, L3, L4, L5, L10, L11, L12, L13, L18, L19, L20 and L22 are striplines on a double Cu-clad printed circuit board with glass microfibre reinforced PTFE, dielectric ( $\epsilon_r = 2.2$ ); thickness 1/16 inch; thickness of copper sheet 2 x 35  $\mu$ m.

The circuit and the components are on one side of the pc board, the other side is unetched copper to serve as ground plane. Earth connections are made by copper straps under the emitter and at the input and output. The emitter-lead is also connected to earth by a hollow rivet.

**Ruggedness in class-AB operation**

The BLV38 is capable of withstanding a load mismatch (VSWR = 3 through all phases) under the following conditions:

$V_{CE} = 35$  V;  $f = 224.25$  MHz;  $T_h = 25$   $^{\circ}$ C;  $P_L = 225$  W.

\* American Technical Ceramics (ATC) capacitor, type 100B or capacitor of same quality.

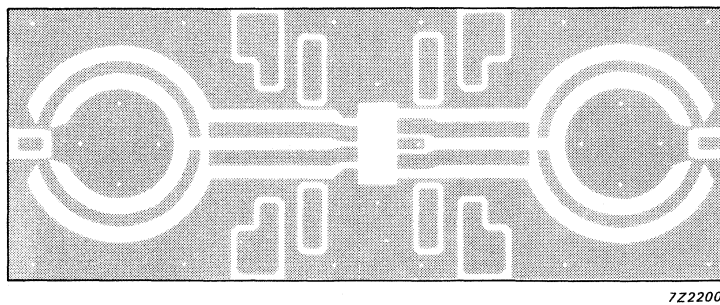
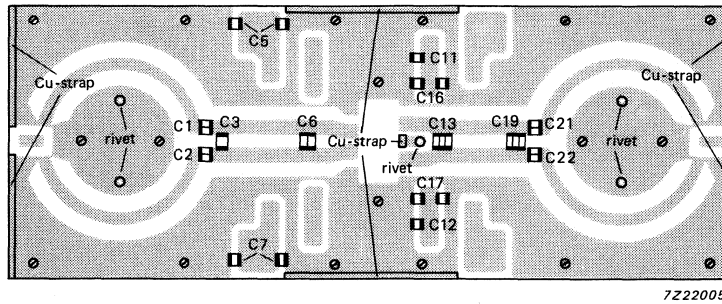
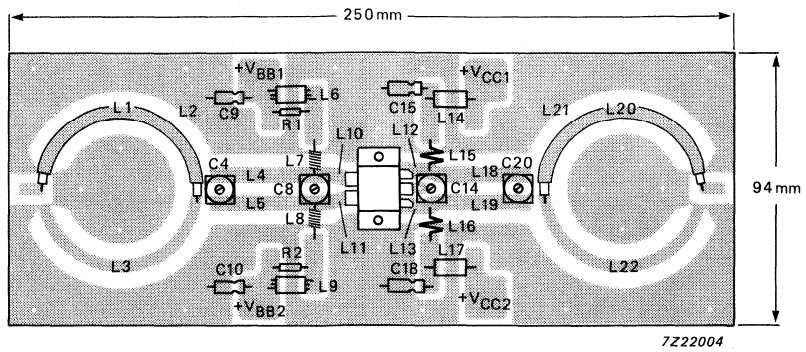


Fig. 3 Component layout and printed-circuit board for 224,25 MHz test circuit.



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in mobile radio transmitters in the 175 MHz communications band.

### Features

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability
- internal matching to achieve an optimum wideband capability and high power gain

The transistor has a 6-lead flange envelope with a ceramic cap (SOT-119). All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	175	45	>6,5	>55

### MECHANICAL DATA

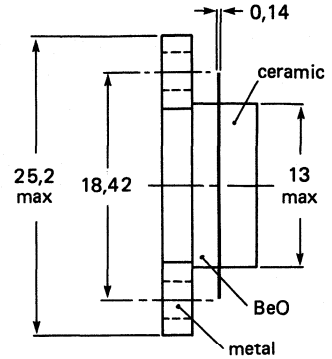
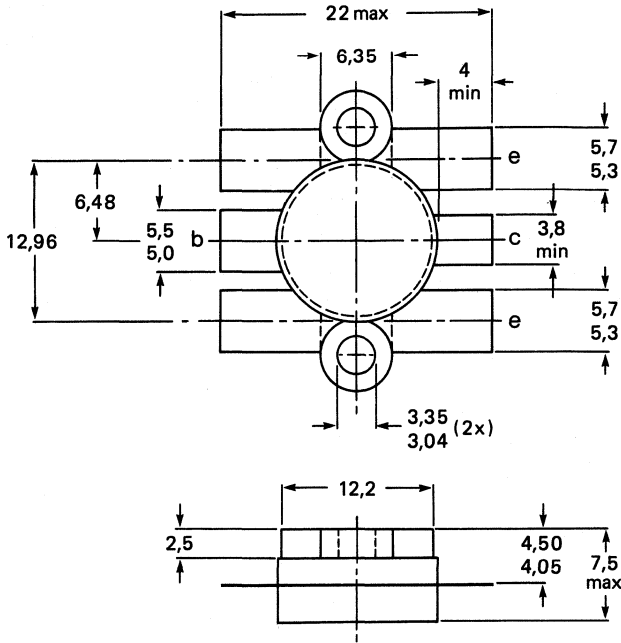
SOT-119 (see Fig. 1)

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-119.

Dimensions in mm



7277385.6

Torque on screw: min. 0,6 Nm  
max. 0,75 Nm

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16,5 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average	$I_C$	max.	9 A
peak value; $f > 1$ MHz	$I_{CM}$	max.	27 A
Total power dissipation at $T_{mb} = 25\text{ }^\circ\text{C}$ ; $f > 1$ MHz	$P_{tot}$	max.	90 W
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$
Operating junction temperature	$T_j$	max.	200 $^\circ\text{C}$

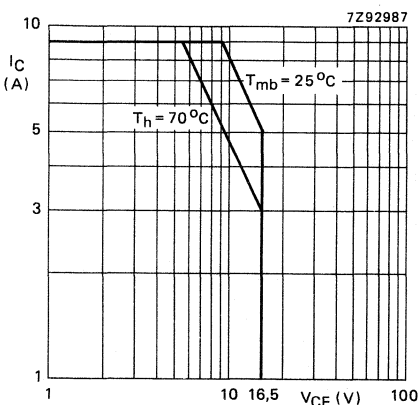


Fig. 2 D.C. soar.  
 $R_{th\ mb-h} = 0,2\ \text{K/W}$ .

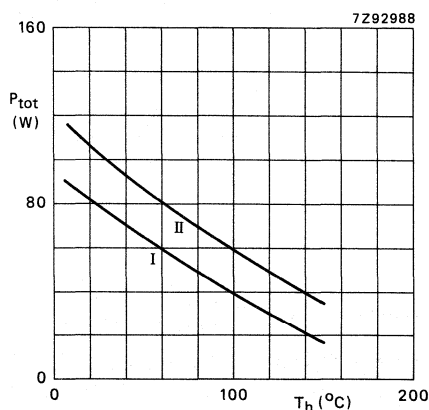


Fig. 3 Power/temperature derating curves;  $R_{th\ mb-h} = 0,2\ \text{K/W}$ .  
I Continuous operation ( $f > 1$  MHz)  
II Short-time operation during mismatch; ( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 68 W;  $T_{mb} = 25\text{ }^\circ\text{C}$

From junction to mounting base  
(r.f. operation)

From mounting base to heatsink

$R_{th\ j-mb}$	=	1,58 K/W
$R_{th\ mb-h}$	=	0,2 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 50\text{ mA}$

$V_{(BR)CBO} > 36\text{ V}$

Collector-emitter breakdown voltage  
open base;  $I_C = 100\text{ mA}$

$V_{(BR)CEO} > 16,5\text{ V}$

Emitter-base breakdown voltage  
open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current  
 $V_{BE} = 0; V_{CE} = 16\text{ V}$

$I_{CES} < 22\text{ mA}$

Second breakdown energy  
 $L = 25\text{ mH}; f = 50\text{ Hz}; R_{BE} = 10\text{ }\Omega$

$E_{SBR} > 12,5\text{ mJ}$

D.C. current gain  
 $V_{CE} = 10\text{ V}; I_C = 6\text{ A}$

$h_{FE} > 15$   
typ. 55

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0; V_{CB} = 12,5\text{ V}$

$C_c$  typ. 130 pF

Collector-flange capacitance

$C_{cf}$  typ. 3 pF

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0; V_{CE} = 12,5\text{ V}$

$C_{re}$  typ. 80 pF

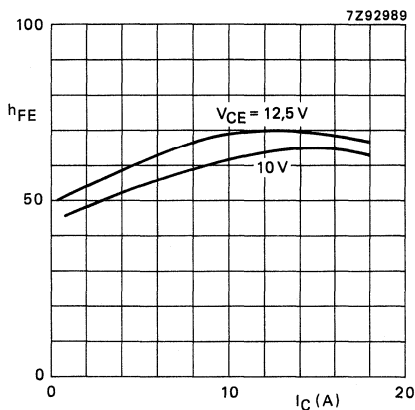


Fig. 4 D.C. current gain versus collector current;  $T_j = 25\text{ }^\circ\text{C}$ .

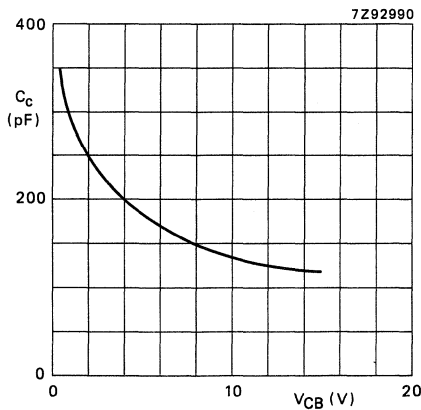


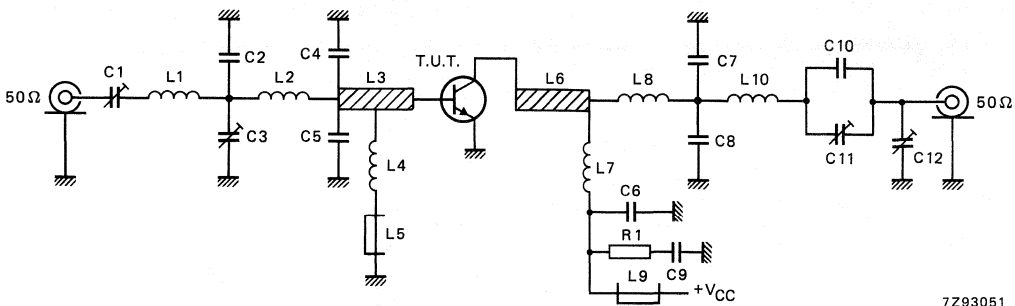
Fig. 5 Output capacitance versus  $V_{CB}$ ;  $I_E = i_e = 0; f = 1\text{ MHz}; T_j = 25\text{ }^\circ\text{C}$

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class-B)

 $f = 175 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ 

mode of operation	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	45	> 6,5 typ. 8,0	> 55 typ. 67



7Z93051

Fig. 6 Class-B test circuit at  $f = 175 \text{ MHz}$ .

## List of components:

- C1 = C11 = C12 = 4 to 40 film dielectric trimmer (cat.no. 2222 809 07008)
  - C2 = C10 = 10 pF multilayer ceramic chip capacitor \*
  - C3 = 2,5 to 20 pF film dielectric trimmer (cat.no. 2222 809 07004)
  - C4 = C5 = 91 pF multilayer ceramic chip capacitor \*
  - C6 = 820 pF multilayer ceramic chip capacitor \*
  - C7 = C8 = 2 x 4,7 pF multilayer ceramic chip capacitors\* in parallel
  - C9 = 100 nF polyester capacitor
  - L1 = strip, 28 mm x 4 mm
  - L2 = 4 turns Cu wire (1,0 mm); int.dia. 4,0 mm; length 7,5 mm; leads 2 x 3,5 mm
  - L3 = strip, 22 mm x 6 mm
  - L4 = 1 turn Cu wire (0,8 mm); int.dia. 3,0 mm; leads 2 x 9 mm
  - L5 = L9 = Ferroxcube wideband h.f. choke, grade 3B (cat.no. 4312 020 36640)
  - L6 = strip, 12 mm x 6 mm
  - L7 = 2 turns enamelled Cu wire (1,6 mm); int.dia. 5,0 mm; length 7,0 mm; leads 2 x 5 mm
  - L8 = 2 turns enamelled Cu wire (1,6 mm); int.dia. 5,0 mm; length 7,0 mm; leads 2 x 3 mm
  - L10 = strip, 18 mm x 4 mm
- L1, L3, L6 and L10 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16 inch.
- R1 = 4,7  $\Omega \pm 10\%$ , carbon resistor

\* American Technical Ceramics capacitor type 100B or capacitor of same quality.

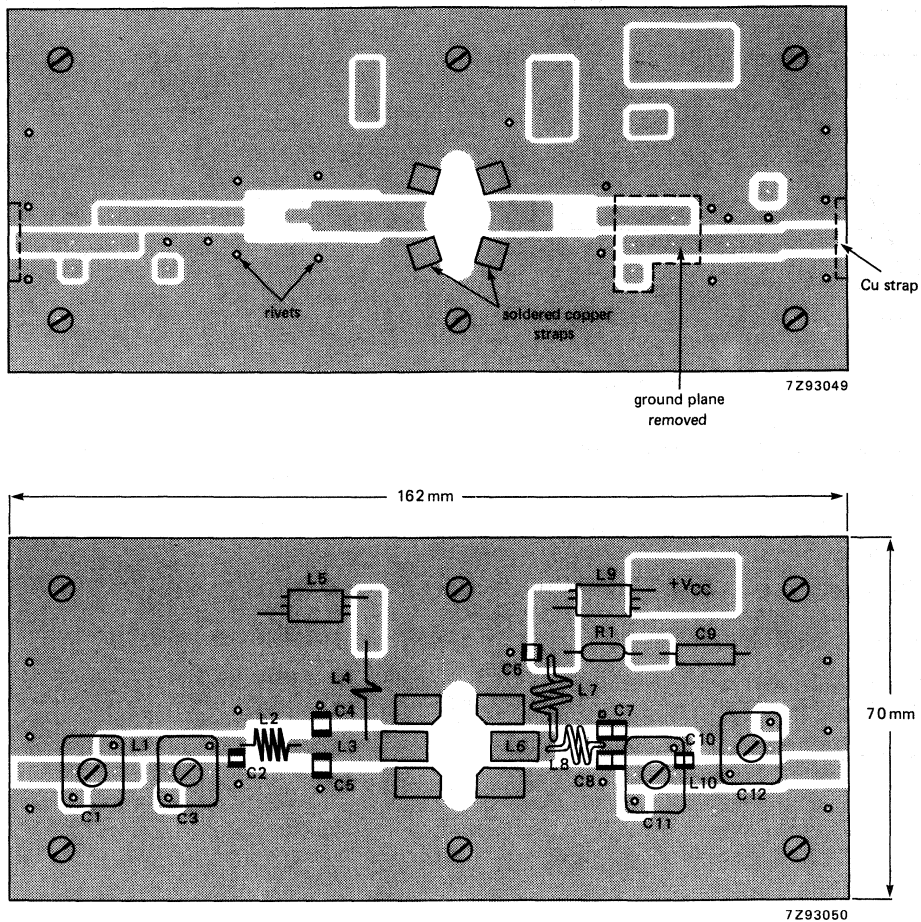


Fig. 7 Printed circuit board and component lay-out for 175 MHz class-B test circuit.

The circuit and components are on one side of the epoxy fibre-glass board. The other side, except for the area indicated by the dotted line, is unetched copper serving as a ground plane.

If the p.c.b. is in direct contact with the heatsink, the heatsink area within the dotted line has to be raised at least 0,5 mm to minimize the dielectric losses.

Earth connections are made by hollow rivets and additionally by fixing screws and copper straps under the emitters to provide a direct contact between the copper of the component side and the ground plane.

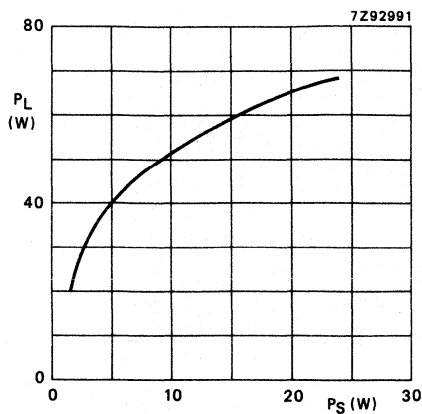


Fig. 8 Load power versus source power.

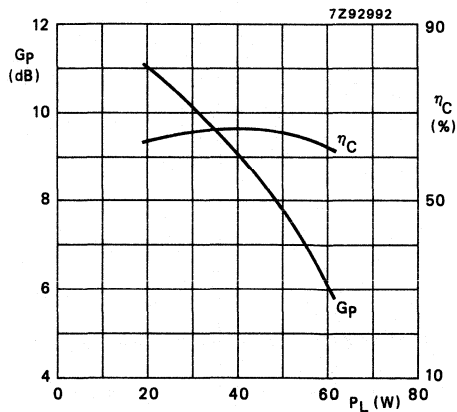


Fig. 9 Power gain and efficiency versus load power.

Condition for Figs 8 and 9:

Typical values;  $V_{CE} = 12,5 \text{ V}$ ;  $f = 175 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

#### Ruggedness in class-B operation

The BLV45/12 is capable of withstanding a load mismatch (VSWR = 20 through all phases) at rated load power up to a supply voltage of  $15,5 \text{ V}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

#### Power slump

If  $T_h$  is increased from  $25 \text{ }^\circ\text{C}$  to  $70 \text{ }^\circ\text{C}$  the output power slump for constant  $P_S$  amounts to typ. 7 % ( $V_{CE} = 12,5$ ;  $f = 175 \text{ MHz}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ ).

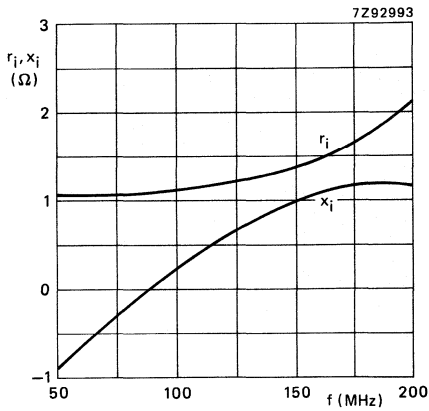


Fig. 10 Input impedance (series components).

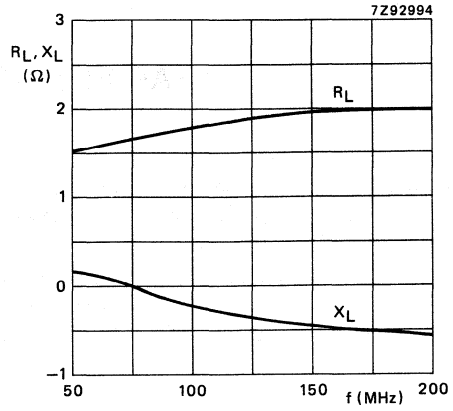


Fig. 11 Load impedance (series components).

Conditions for Figs 10, 11 and 12:

Typical values;  $V_{CE} = 12,5$  V;  $P_L = 45$  W;  $f = 50$  to 200 MHz;  $R_{th\ mb-h} = 0,2$  K/W.

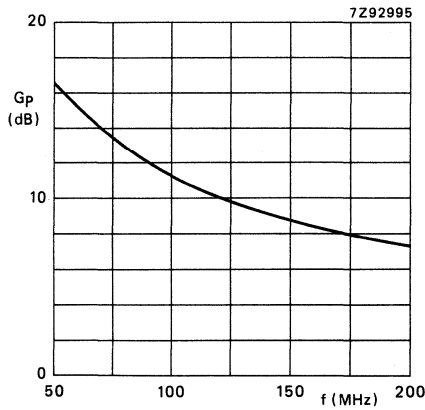


Fig. 12 Power gain versus frequency.



## U.H.F. LINEAR PUSH-PULL POWER TRANSISTOR

Two n-p-n silicon planar epitaxial transistor sections in one envelope to be used as push-pull amplifier, primarily intended for use in linear u.h.f. television transmitters and transposers.

### Features:

- internally matched input for wideband operation and high power gain;
- internal midpoint (r.f. ground) reduces negative feedback and improves power gain;
- increased input and output impedances (compared with single-ended transistors) simplify wideband matching;
- length of the external emitter leads is not critical;
- diffused emitter ballasting resistors for an optimum temperature profile;
- gold metallization ensures excellent reliability.

The envelope is an 8-lead flange type with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance in linear amplifier

mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C1}} = I_{\text{C2}}$ A	$I_{\text{C}}(\text{ZS})$ A	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{o sync}}^*$ W	$P_{\text{L}}$ W	$G_{\text{p}}$ dB
class-A	860	25	0,85	—	70 25	-60 -55	> 6 typ. 12	—	> 8,0 typ. 9,0
class-AB	860	25	1,25	2 x 0,1	25	—	—	typ. 38**	typ. 6,5**

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

\*\* Power gain compression is 1 dB.

### MECHANICAL DATA

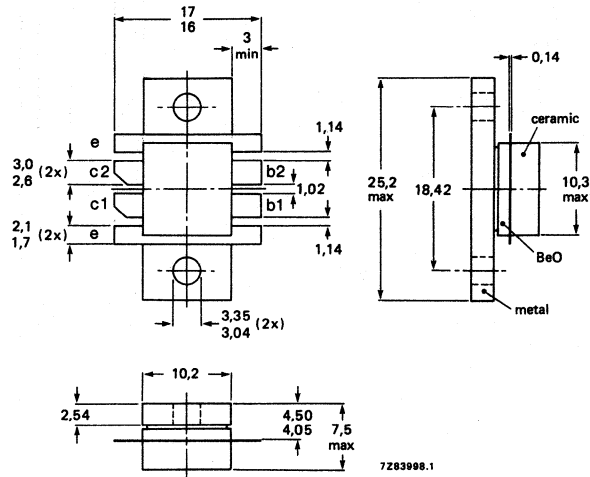
SOT-161 (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-161.

Dimensions in mm



Torque on screw: min. 0,6 Nm (6 kg cm)  
 max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage

(peak value);  $V_{BE} = 0$

$V_{CESM}$  max. 50 V

open base

$V_{CEO}$  max. 27 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 3,5 V

Collector current per transistor section

d.c. or average

$I_C; I_{C(AV)}$  max. 2 A

(peak value);  $f > 1$  MHz

$I_{CM}$  max. 4 A

Total power dissipation at  $T_{mb} = 25$  °C\*

$P_{tot}$  max. 77 W\*

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C\*

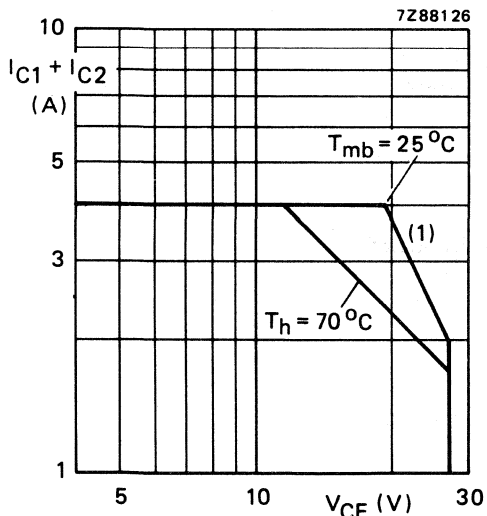
$P_{rf}$  max. 93 W\*

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.\*

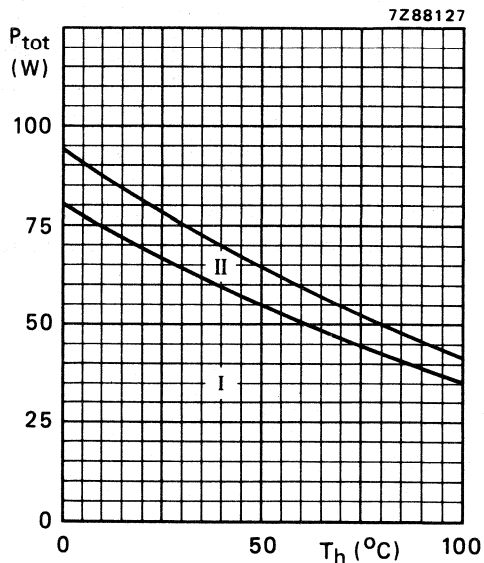


Fig. 3 Power derating curves vs. temperature.\*

- I Continuous d.c. (including r.f. class-A) operation
- II Continuous r.f. operation

**THERMAL RESISTANCE** (dissipation = 42 W;  $T_{mb} = 80,5$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th j-mb(dc)}$  = 2,43 K/W

From junction to mounting base (r.f. dissipation)

$R_{th j-mb(rf)}$  = 1,91 K/W

From mounting base to heatsink

$R_{th mb-h}$  = 0,25 K/W

\* Dissipation of either transistor section should not exceed half rated dissipation.

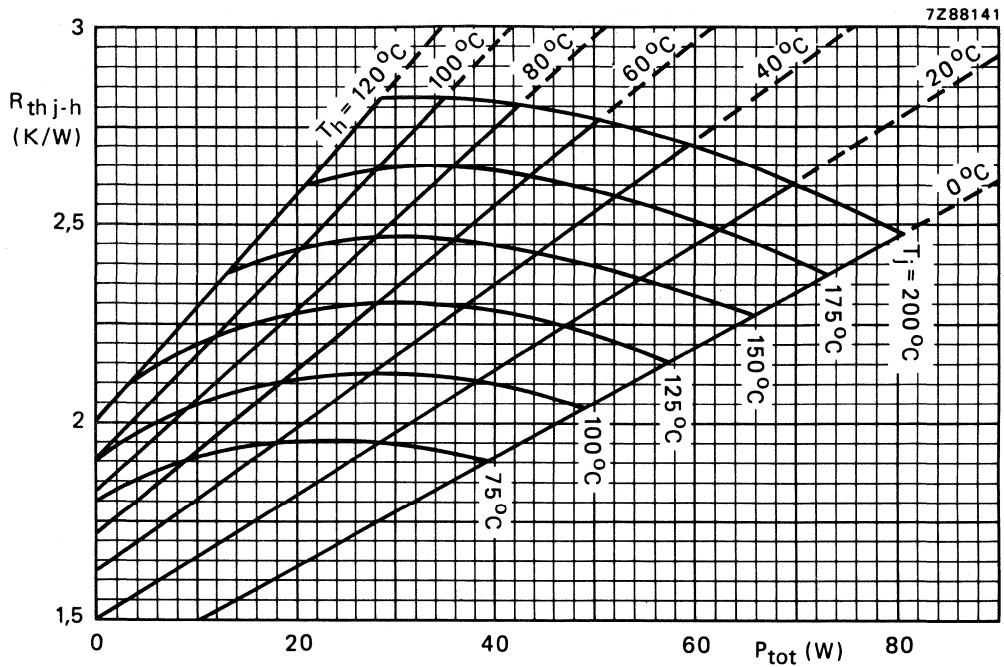


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,25\text{ K/W.}$ )

**Example**

Nominal class-A push-pull operation (without r.f. signal):  $V_{CE} = 25\text{ V}$ ;  $I_{C1} = I_{C2} = 0,85\text{ A}$ ;  $T_h = 70\text{ °C}$ .

Fig. 4 shows:  $R_{th\ j-h}$  max. 2,68 K/W  
 $T_j$  max. 184 °C

Typical device:  $R_{th\ j-h}$  typ. 2,28 K/W  
 $T_j$  typ. 167 °C

**CHARACTERISTICS apply to either transistor section unless otherwise specified** $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 50\text{ V}$ open base;  $I_C = 25\text{ mA}$  $V_{(BR)CEO} > 27\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 5\text{ mA}$  $V_{(BR)EBO} > 3,5\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 27\text{ V}$  $I_{CES} < 10\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $ESBO > 2\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $ESBR > 2\text{ mJ}$ 

D.C. current gain\*

 $I_C = 0,85\text{ A}; V_{CE} = 25\text{ V}$  $h_{FE} >$   
typ. 40

D.C. current gain ratio of transistor sections

 $I_C = 0,85\text{ A}; V_{CE} = 25\text{ V}$ 

0,67 to 1,5

Collector-emitter saturation voltage\*

 $I_C = 1,7\text{ A}; I_B = 0,17\text{ A}$  $V_{CEsat}$  typ. 0,75 VTransition frequency at  $f = 100\text{ MHz}^{**}$  $-I_E = 0,85\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 2,5 GHz $-I_E = 1,7\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 2,5 GHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 25\text{ V}$  $C_c$  typ. 24 pF  
< 30 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 50\text{ mA}; V_{CE} = 25\text{ V}$  $C_{re}$  typ. 15 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0,02$ .\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}; \delta \leq 0,01$ .

The graphs apply to either transistor section.

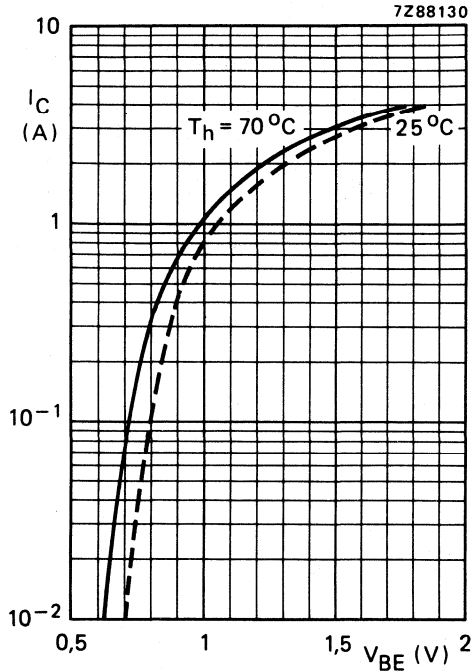


Fig. 5 Typical values;  $V_{CE} = 25\text{ V}$ .

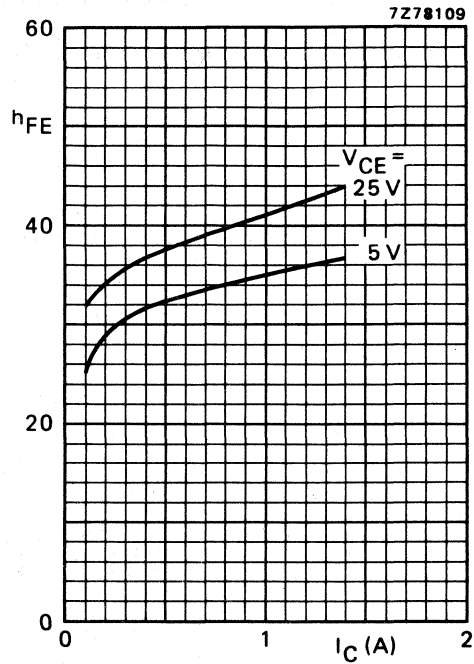


Fig. 6 Typical values;  $T_j = 25^\circ\text{C}$ .

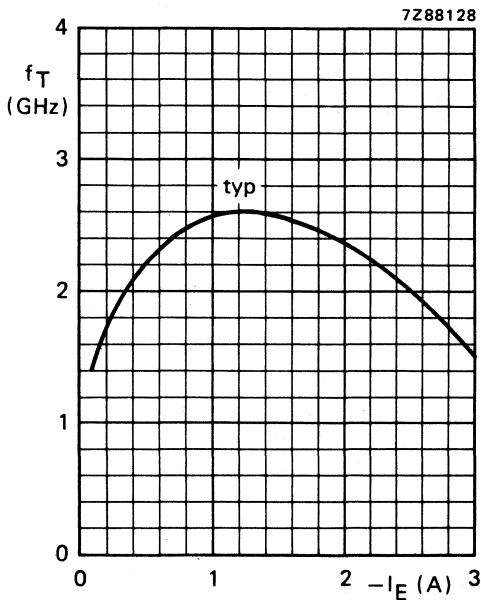


Fig. 7  $V_{CB} = 25\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

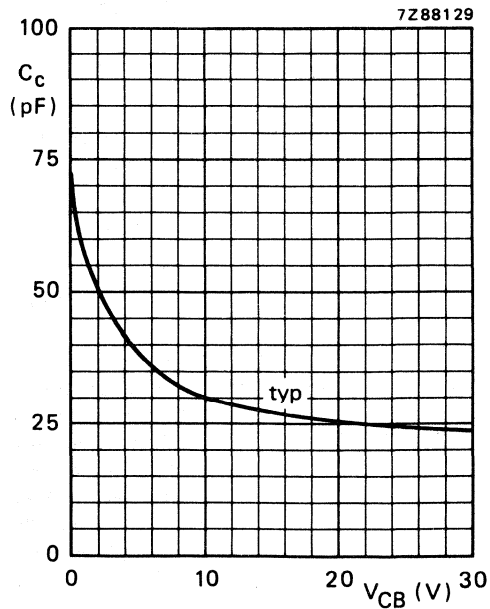


Fig. 8  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in u.h.f. class-A operation (linear push-pull power amplifier)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C1}} = I_{\text{C2}}$ (A)	$T_{\text{h}}$ ( $^{\circ}\text{C}$ )	$d_{\text{im}}^*$ (dB)	$P_{\text{o sync}}^*$ (W)	$G_{\text{p}}$ (dB)
860	25	0,85	70	-60	> 6	> 8,0
			70	-60	typ. 7,5	typ. 8,5
			70	-55	typ. 10	typ. 8,5
			25	-55	typ. 12	typ. 9,0

\* Three-tone test method (vision carrier  $-8$  dB, sound carrier  $-7$  dB, sideband signal  $-16$  dB), zero dB corresponds to peak sync level.

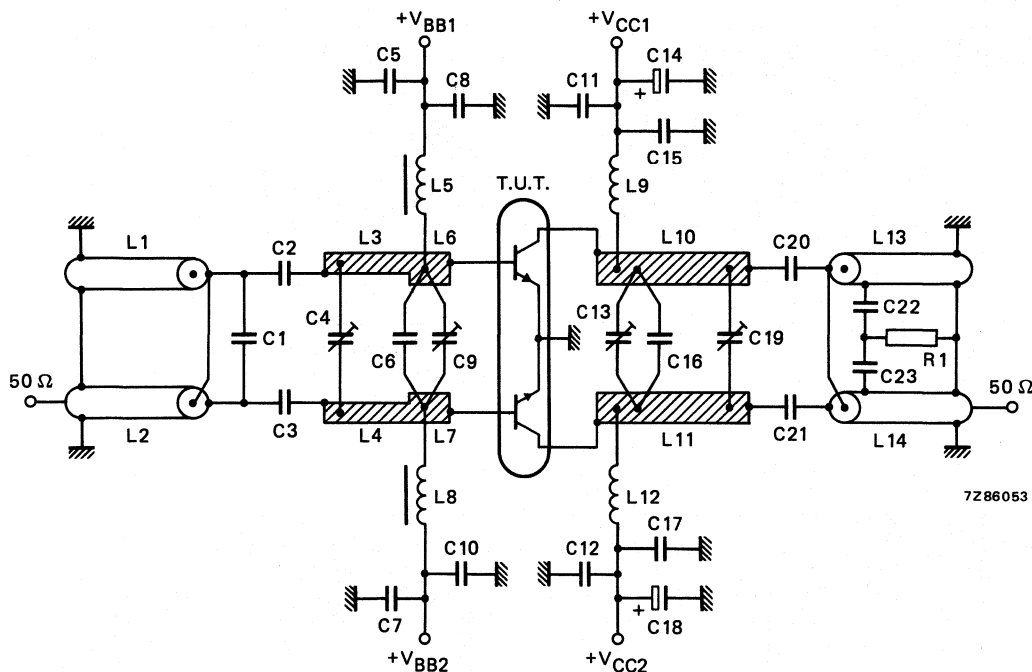


Fig. 9 Class-A test circuit at  $f_{\text{vision}} = 860$  MHz.

List of components:

- C1 = C6 = C16 = 4,7 pF (500 V) multilayer ceramic chip capacitor (ATC▲)
- C2 = C3 = C20 = C21 = 33 pF multilayer ceramic chip capacitor (cat. no. 2222 851 13339)
- C4 = C9 = C13 = C19 = 1,2 to 3,5 pF film dielectric trimmer (cat. no. 2222 809 05001)
- C5 = C7 = C15 = C17 = 100 nF multilayer ceramic chip capacitor (cat. no. 2222 852 59104)
- C8 = C10 = C11 = C12 = 220 pF multilayer ceramic chip capacitor (cat. no. 2222 852 13221)
- C14 = C18 = 6,8  $\mu\text{F}/40$  V solid aluminium electrolytic capacitor
- C22 = C23 = 1 pF (500 V) multilayer ceramic chip capacitor (ATC▲)
- C9 and C13 are placed 8,0 and 14,0 mm from transistor edge, respectively.

▲ ATC means American Technical Ceramics.

L1 = L2 = L13 = L14 = 50  $\Omega$  semi-rigid cable; outer diameter 2,2 mm; length 29,0 mm. These cables are soldered on 75  $\Omega$  striplines (1,1 mm x 28,0 mm). The centre conductors of the cables L1 and L13 are not connected.

L3 = L4 = 52  $\Omega$  stripline (2,0 mm x 16,5 mm)

L5 = L8 = 470 nH microchoke

L6 = L7 = 39  $\Omega$  stripline (3,1 mm x 8,0 mm)

L9 = L12 = 1 turn Cu wire (1,0 mm); int. dia. 5,5 mm; leads 2 x 3,5 mm

L10 = L11 = 39  $\Omega$  stripline (3,1 mm x 34,0 mm)

L3, L4, L6, L7, L10 and L11 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/32".

R1 = 10  $\Omega$  carbon resistor

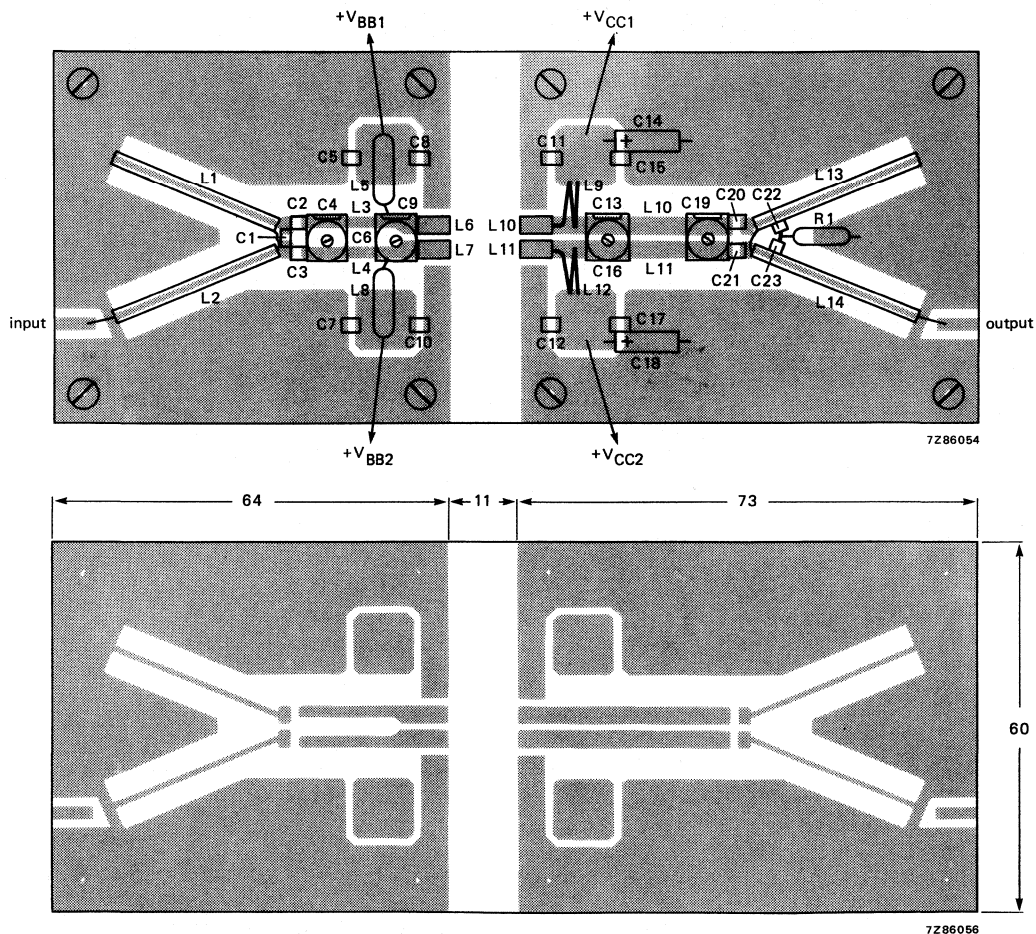


Fig. 10 Component layout and printed-circuit board for 860 MHz class-A test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board, the other side is unetched copper to serve as a ground-plane. Earth connections are made by means of bolts. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.



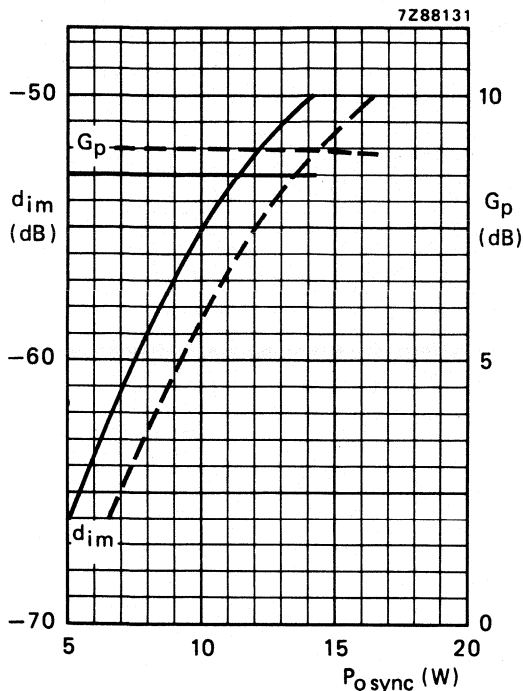


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and power gain as a function of output power.

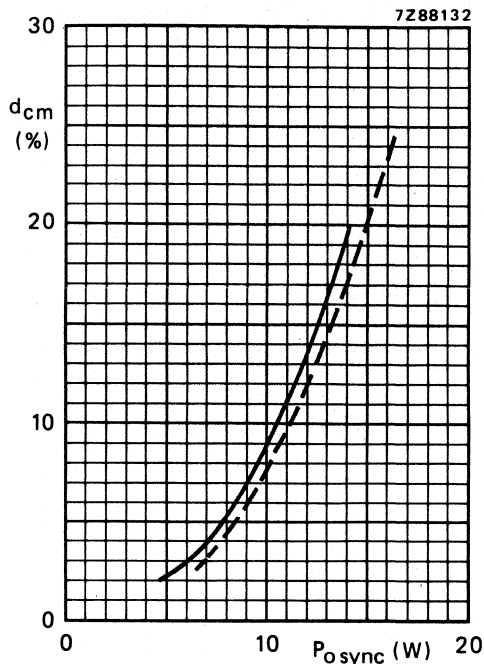


Fig. 12 Cross-modulation distortion ( $d_{cm}$ )\*\* as a function of output power.

Conditions for Figs 11 and 12:

Typical values;  $V_{CE} = 25$  V;  $I_C = 2 \times 0,85$  A; ---  $T_h = 25$  °C; —  $T_h = 70$  °C;  $f_{\text{vision}} = 860$  MHz.

**Ruggedness in push-pull class-A operation**

The BLV57 is capable of withstanding full load mismatch (VSWR = 50 through all phases) under the following conditions:

$V_{CE} = 25$  V;  $I_C = 2 \times 0,85$  A;  $T_h = 70$  °C;  $P_{o\text{sync}}^* \leq 12,5$  W;  $f = 860$  MHz;  $R_{th\text{ mb-h}} = 0,25$  K/W. At any other composition of the output signal:  $P_L$  (r.m.s. value)  $\leq 5$  W.

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

Intermodulation distortion of input signal  $\leq -70$  dB.

\*\* Two-tone test method (vision carrier 0 dB, sound carrier -7 dB), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from 0 dB to -20 dB.

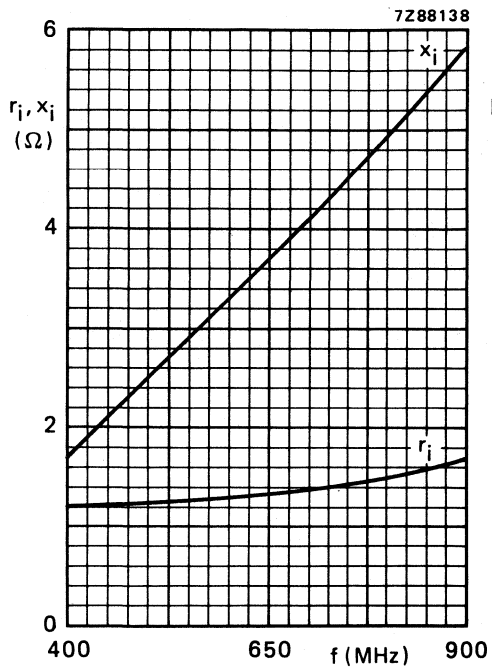


Fig. 20 Input impedance (series components).

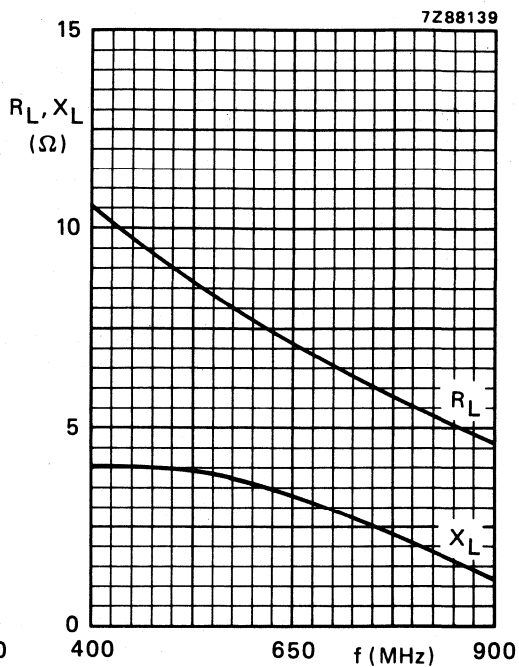


Fig. 21 Load impedance (series components).

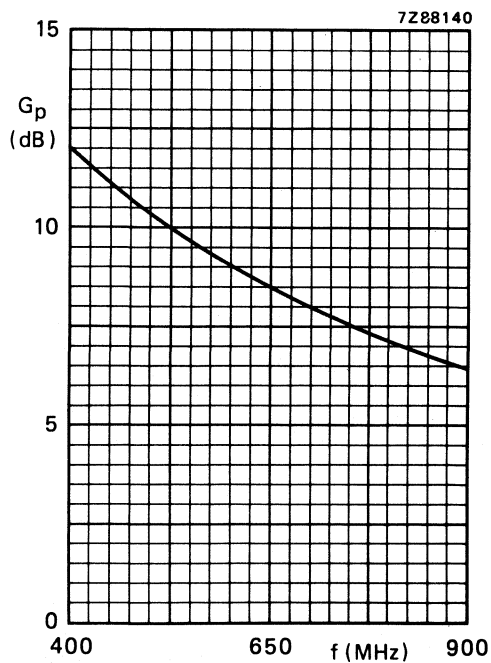


Fig. 22.

Conditions for Figs 20; 21 and 22:

The graphs apply to either transistor section assuming class-AB push-pull operation.

Typical values;  $V_{CE} = 25$  V;  $I_{C(ZS)} = 0,1$  A;  $P_L = 17,5$  W (P.E.P.);  $T_h = 70$  °C.

## APPLICATION INFORMATION

R.F. performance in u.h.f. class-AB operation (c.w.)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C(ZS)}}$ (A)	$T_{\text{h}}$ (°C)	$P_{\text{L}}$ (W)	$I_{\text{C1}} = I_{\text{C2}}$ (A)	$\eta$ (%)	$G_{\text{p}}^*$ (dB)
860	25	2 x 0,1	25	12,5 38	typ. 1,25	typ. 60	typ. 7,5 typ. 6,5
860	25	2 x 0,1	70	12,5 30	typ. 1,10	typ. 55	typ. 7,0 typ. 6,0

\* Typical values are based on 1 dB gain compression. Using a 3rd order amplitude transfer characteristic, 1 dB compression corresponds with 30% sync input/25% sync output compression in television service (negative modulation, C.C.I.R. system).

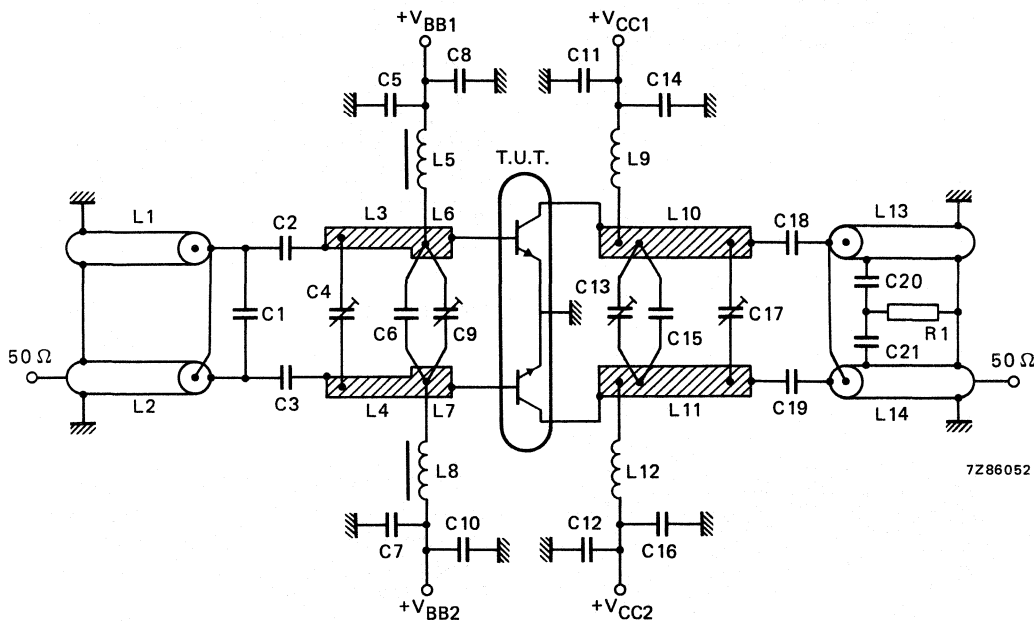


Fig. 16 Class-AB test circuit at  $f_{\text{vision}} = 860$  MHz.

List of components:

- C1 = C6 = C15 = 4,7 pF (500 V) multilayer ceramic chip capacitor (ATC▲)
  - C2 = C3 = C18 = C19 = 33 pF multilayer ceramic chip capacitor (cat. no. 2222 851 13339)
  - C4 = C9 = C13 = C17 = 1,2 to 3,5 pF film dielectric trimmer (cat. no. 2222 809 05001)
  - C5 = C7 = C14 = C16 = 100 nF multilayer ceramic chip capacitor (cat. no. 2222 852 59104)
  - C8 = C10 = C11 = C12 = 220 pF multilayer ceramic chip capacitor (cat. no. 2222 852 13221)
  - C20 = C21 = 1 pF (500 V) multilayer ceramic chip capacitor (ATC▲)
- C9 and C13 are placed 8,0 and 14,0 mm from transistor edge, respectively.

▲ ATC means American Technical Ceramics.

L1 = L2 = L13 = L14 = 50  $\Omega$  semi-rigid cable; outer diameter 2,2 mm; length 29,0 mm. These cables are soldered on 75  $\Omega$  striplines (1,1 mm x 28,0 mm). The centre conductors of the cables L1 and L13 are not connected.

L3 = L4 = 52  $\Omega$  stripline (2,0 mm x 16,5 mm)

L5 = L8 = 470 nH microchoke

L6 = L7 = 39  $\Omega$  stripline (3,1 mm x 8,0 mm)

L9 = L12 = 1 turn Cu wire (1,0 mm); int. dia. 5,5 mm; leads 2 x 3,5 mm

L10 = L11 = 39  $\Omega$  stripline (3,1 mm x 34,0 mm)

L3, L4, L6, L7, L10 and L11 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/32".

R1 = 10  $\Omega$  carbon resistor

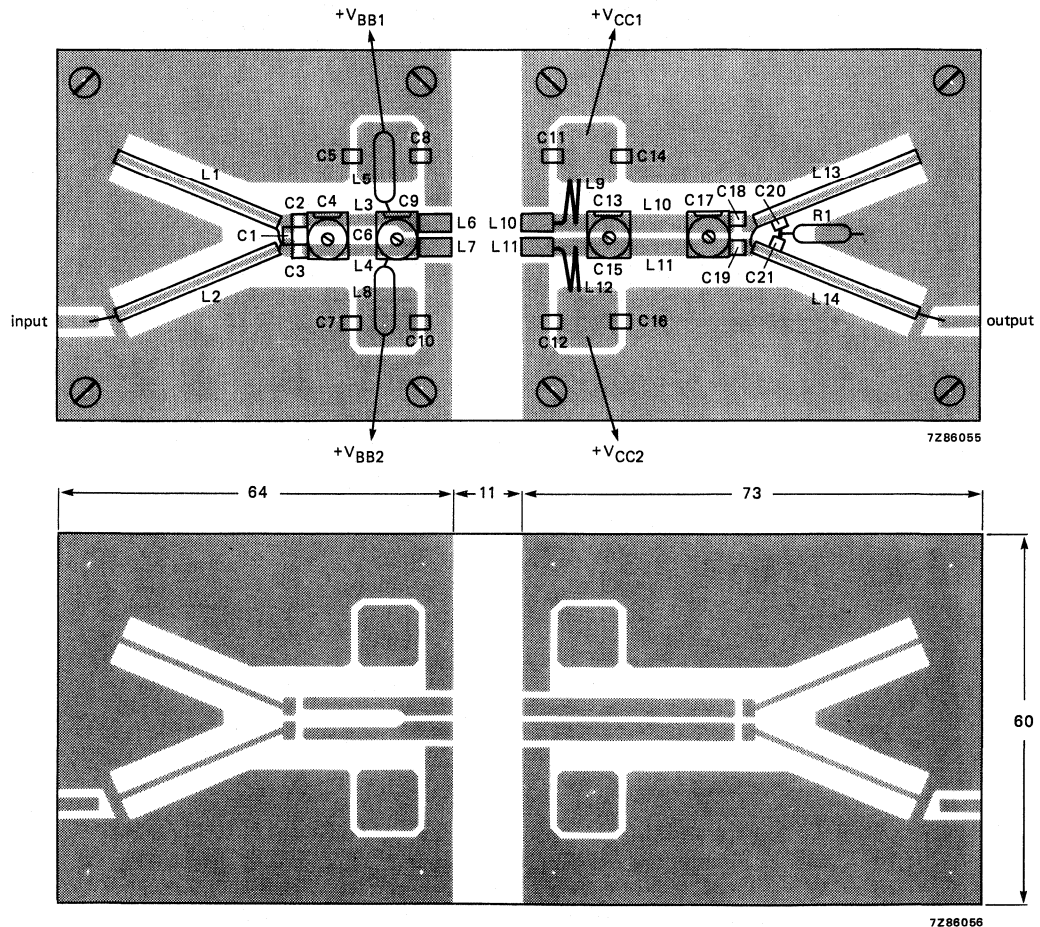


Fig. 17 Component layout and printed-circuit board for 860 MHz class-AB test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board, the other side is unetched copper to serve as a ground-plane. Earth connections are made by means of bolts. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.

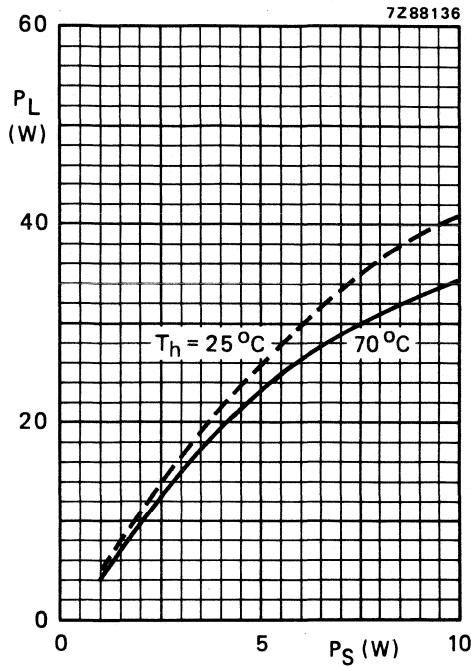


Fig. 18 Typical values;  $V_{CE} = 25$  V;  
 $I_{C(ZS)} = 2 \times 0,1$  A;  $f_{\text{vision}} = 860$  MHz.

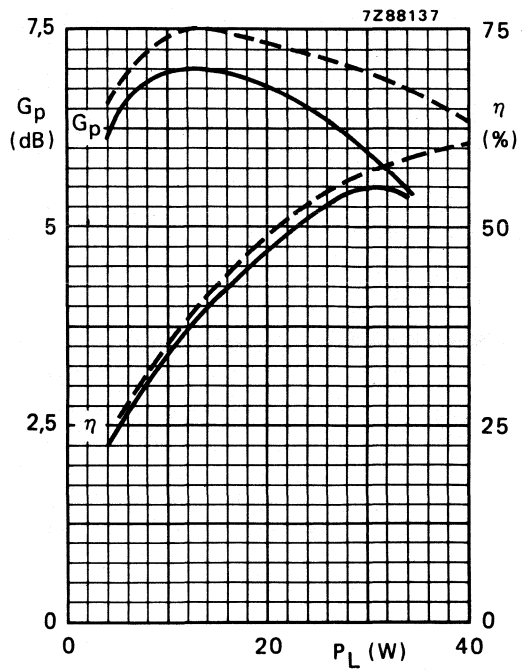


Fig. 19 Typical values;  $V_{CE} = 25$  V;  
 $I_{C(ZS)} = 2 \times 0,1$  A; ---  $T_h = 25^\circ\text{C}$ ;  
 —  $T_h = 70^\circ\text{C}$ ;  $f_{\text{vision}} = 860$  MHz.

**Ruggedness in class-AB operation**

The BLV57 is capable of withstanding a load mismatch ( $VSWR \leq 2$  through all phases) up to 30 W (r.m.s. value) or ( $VSWR \leq 50$  through all phases) up to 19 W under the following conditions:  $V_{CE} = 25$  V;  $T_h = 70^\circ\text{C}$ ;  $f = 860$  MHz;  $R_{th\ mb-h} = 0,25$  K/W.

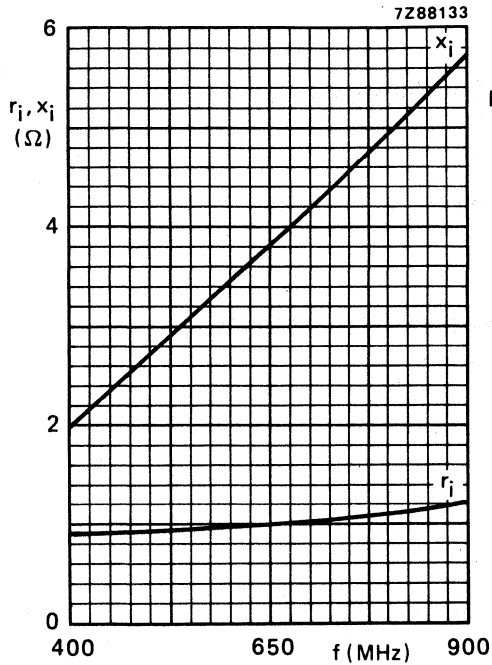


Fig. 13 Input impedance (series components).

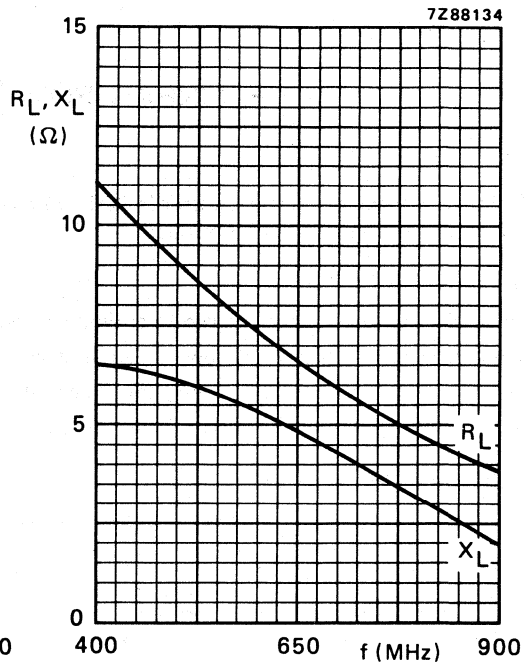


Fig. 14 Load impedance (series components).

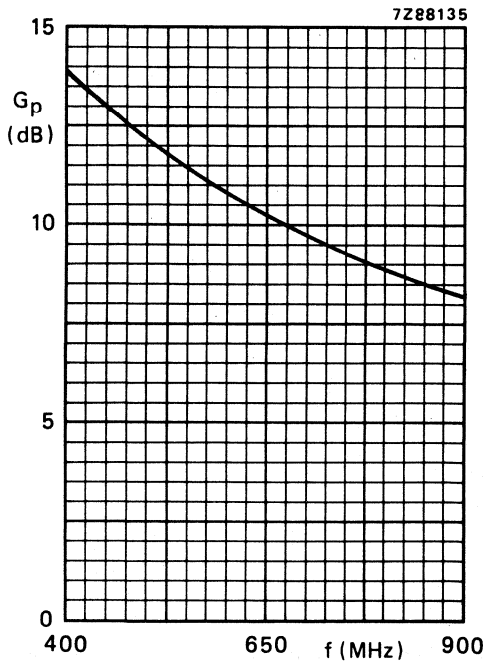


Fig. 15.

Conditions for Figs 13, 14 and 15:

The graphs apply to either transistor section assuming class-A push-pull operation.

Typical values;  $V_{CE} = 25$  V;  $I_C = 0,85$  A;

$T_h = 70$  °C.

## U.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor in SOT-171 envelope primarily intended for use as linear amplifier in u.h.f. television transmitters.

### Features:

- internal input matching to achieve an optimum wideband capability and high power gain
- emitter-ballasting resistors for lower junction temperatures.
- titanium-platinum-gold ensures long life and excellent reliability.

The transistor has a 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in common emitter class-AB circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
class AB; c.w.	25	860	30	min. 7,0	min. 50

### MECHANICAL DATA

SOT-171 (see Fig. 1).

Dimensions in mm

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

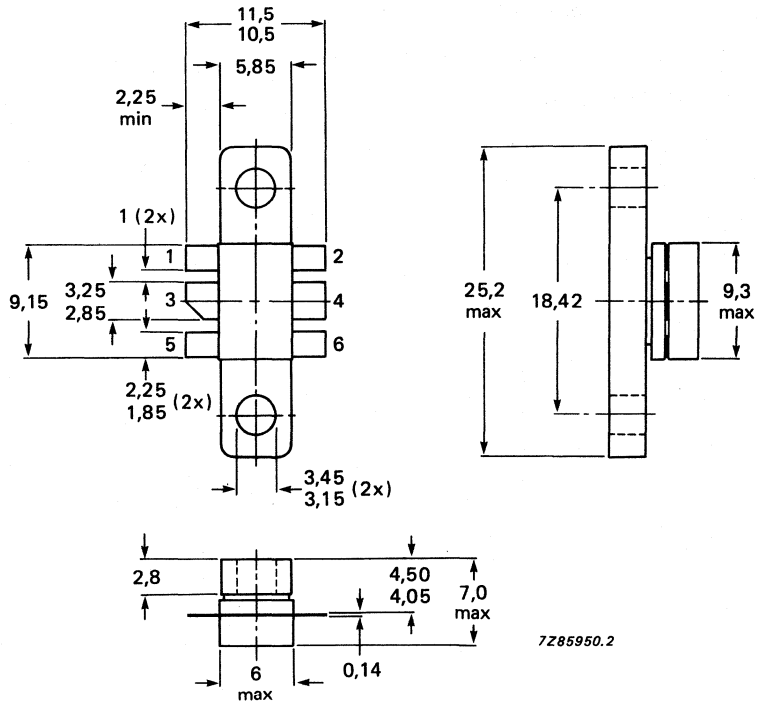
**MECHANICAL DATA**

Dimensions in mm

Fig. 1 SOT-171.

**Pinning:**

- 1 Emitter
- 2 Emitter
- 3 Collector
- 4 Base
- 5 Emitter
- 6 Emitter



7Z85950.2

Torque on screw: min. 0,6 Nm (6 kg.cm)  
 max. 0,75 Nm (7,5 kg.cm)

Recommended screw : cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.



**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	V <sub>CB0</sub>	max.	50 V
Collector-emitter voltage (open base)	V <sub>CE0</sub>	max.	27 V
Emitter-base voltage (open collector)	V <sub>EBO</sub>	max.	3,5 V
Collector current			
d.c. or average	I <sub>C</sub>	max.	3 A
(peak value); f > 1 MHz	I <sub>CM</sub>	max.	9 A
Total power dissipation			
at T <sub>mb</sub> = 25 °C; f > 1 MHz	P <sub>tot</sub>	max.	70 W
Storage temperature	T <sub>stg</sub>		-65 to +150 °C
Operating junction temperature	T <sub>j</sub>	max.	200 °C

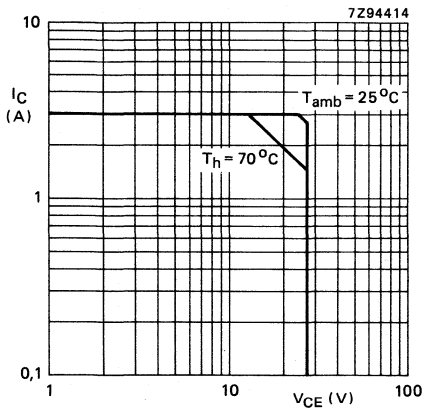


Fig. 2 D.C. SOAR; R<sub>th mb-h</sub> = 0,4 K/W.

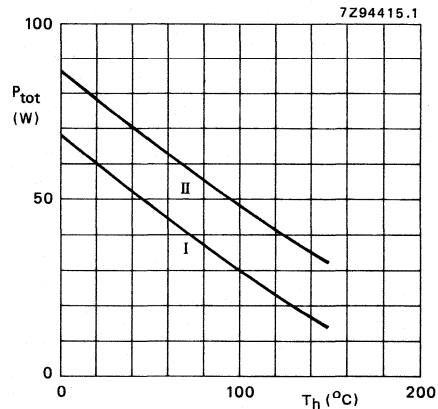


Fig. 3 Power/temperature derating curves versus heatsink temperature.

- I Continuous operation (f > 1 MHz)
- II Short-time operation during mismatch (f > 1 MHz)

**MAXIMUM THERMAL RESISTANCE**

Dissipation = 50 W; T<sub>amb</sub> = 25 °C

From junction to mounting base

R<sub>th j-mb</sub> max. 2,3 K/W

From mounting base to heatsink

R<sub>th mb-h</sub> max. 0,4 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 50\text{ mA}$

Collector-emitter breakdown voltage  
open base;  $I_C = 100\text{ mA}$

Emitter-base breakdown voltage  
open collector;  $I_E = 10\text{ mA}$

Collector leakage current  
 $V_{BE} = 0$ ;  $V_{CE} = 27\text{ V}$

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

D.C. current gain  
 $V_{CE} = 20\text{ V}$ ;  $I_C = 2\text{ A}$

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0$ ;  $V_{CB} = 25\text{ V}$

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0$ ;  $V_{CE} = 25\text{ V}$

Collector-flange capacitance

$V_{(BR)CBO}$	min.	50 V
$V_{(BR)CEO}$	min.	27 V
$V_{(BR)EBO}$	min.	3,5 V
$I_{CES}$	max.	10 mA
$E_{SBR}$	min.	4 mJ
$h_{FE}$	min.	15
$C_c$	typ.	44 pF
$C_{re}$	typ.	30 pF
$C_{cf}$	typ.	2 pF

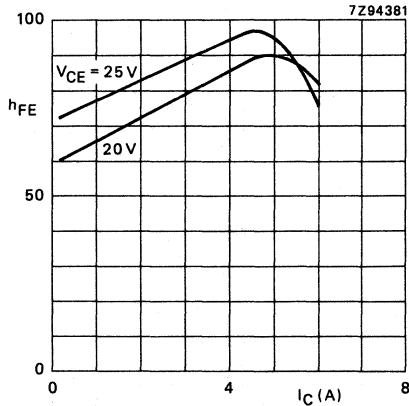


Fig. 4 D.C. current gain versus collector current;  $T_j = 25\text{ }^\circ\text{C}$ .

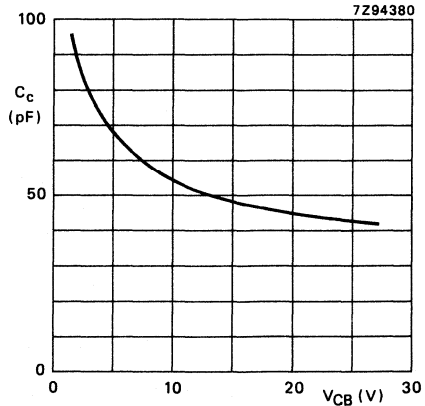


Fig. 5 Output capacitance versus  $V_{CB}$ ;  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ .

## APPLICATION INFORMATION

R.F. performance up to  $T_h = 25^\circ\text{C}$  in common emitter class-AB circuit (c.w.);  $R_{th\text{ mb-h}} = 0,4\text{ K/W}$

f (MHz)	$V_{CE}$ (V)	$I_{C(ZS)}$ (mA)	$G_p$ (dB)	$P_L$ (W)	$\eta$ (%)	$\Delta G_p$ (dB)▲
860	25	60	min. 7,0 typ. 8,5	30	min. 50 typ. 55	max. 1,0 typ. 0,2

- ▲ Assuming a 3rd-order amplitude transfer characteristic, 1 dB gain compression corresponds with 30% sync input/25% sync output compression in television service (negative modulation, C.C.I.R. system).

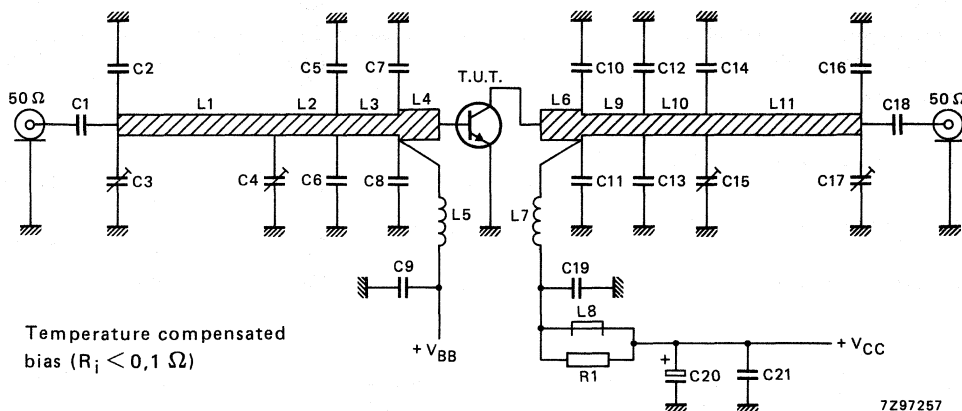


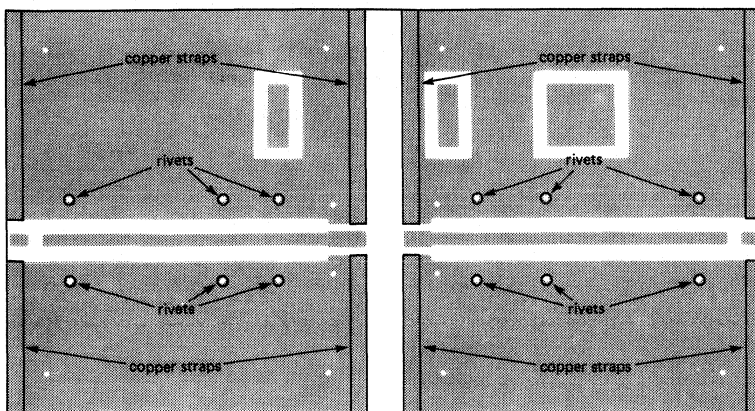
Fig. 6 Class-AB test circuit at  $f = 860\text{ MHz}$ .

## List of components:

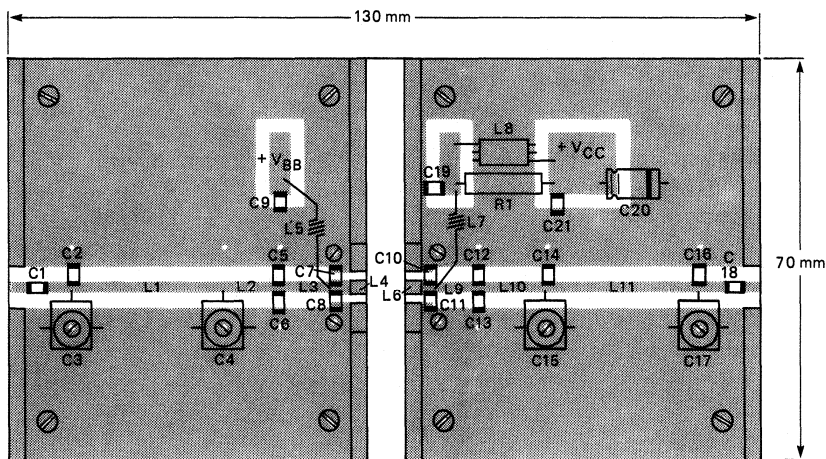
- C1 = C18 = 33 pF multilayer ceramic chip capacitor\*
- C2 = C14 = C16 = 3,6 pF multilayer ceramic chip capacitor\*
- C3 = C4 = C15 = C17 = 1,4 – 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C5 = C6 = 1,8 pF multilayer ceramic chip capacitor\*
- C7 = C8 = 6,2 pF multilayer ceramic chip capacitor\*
- C9 = C21 = 330 pF multilayer ceramic chip capacitor\*
- C10 = C11 = 5,6 pF multilayer ceramic chip capacitor\*\*
- C12 = 5,6 pF multilayer ceramic chip capacitor\*
- C13 = 6,2 pF multilayer ceramic chip capacitor\*
- C19 = 10 pF multilayer ceramic chip capacitor\*
- C20 = 6,8  $\mu\text{F}$  (63 V) electrolytic capacitor
- L1 = L11 = 50  $\Omega$  stripline (26 mm x 2,4 mm)
- L2 = L3 = 50  $\Omega$  stripline (9,5 mm x 2,4 mm)
- L4 = 42,6  $\Omega$  stripline (6,0 mm x 3,0 mm)
- L5 = 60 nH; 4 turns closely wound enamelled Cu-wire (0,4 mm) int. dia. 3 mm; leads 2 x 5 mm.
- L6 = 42,6  $\Omega$  stripline (4,0 mm x 3,0 mm)
- L7 = 45 nH; 4 closely wound enamelled Cu-wire (1 mm); int. dia. 4 mm; leads 2 x 5 mm
- L8 = Ferroxcube h.f. choke, grade 3B (cat.no. 4312 020 36642)
- L9 = 50  $\Omega$  stripline (9,0 mm x 2,4 mm)
- L10 = 50  $\Omega$  stripline (13,5 mm x 2,4 mm)
- R1 = 10  $\Omega \pm 5\%$ , 1 W metal film resistor

The striplines are on a double Cu-clad printed circuit board with a P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch.

- \* American Technical Ceramics type 100B or capacitor of the same quality.
- \*\* American Technical Ceramics type 100A or capacitor of the same quality.



7297259



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Fig. 7 Printed circuit board and component layout for 860 MHz class-AB test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board; the other side is unetched copper serving as a ground plane. Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the bases to provide a direct contact between the copper on the component side and the ground plane.

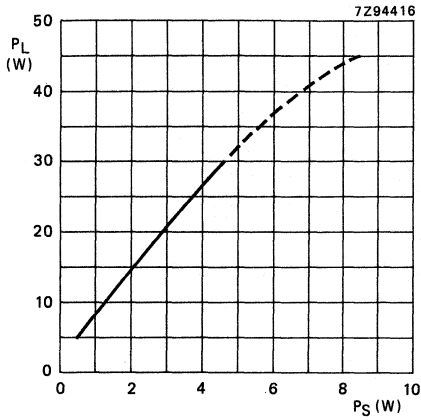


Fig. 8 Load power versus source power.

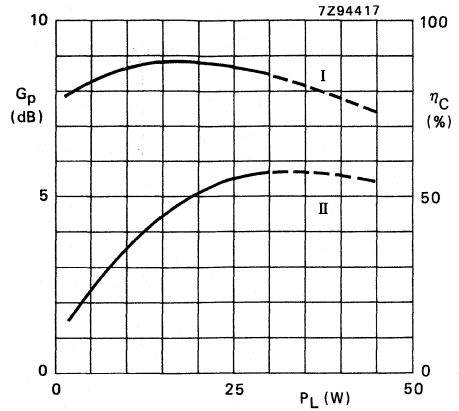


Fig. 9 Power gain (I) and efficiency versus load power (II).

Conditions for Figs 8 and 9:

Typical values;  $V_{CE} = 25 \text{ V}$ ;  $f = 860 \text{ MHz}$ ;  $I_{C(ZS)} = 60 \text{ mA}$ ;  $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} = 0,4 \text{ K/W}$ ; class-AB operation.

**RUGGEDNESS**

The BLV59 is capable of withstanding load mismatch (VSWR = 10 through all phases) at rated load power under the following conditions;  $V_{CE} = 25 \text{ V}$ ;  $f = 860 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,4 \text{ K/W}$ ;  $I_{C(ZS)} = 60 \text{ mA}$  (class-AB operation).

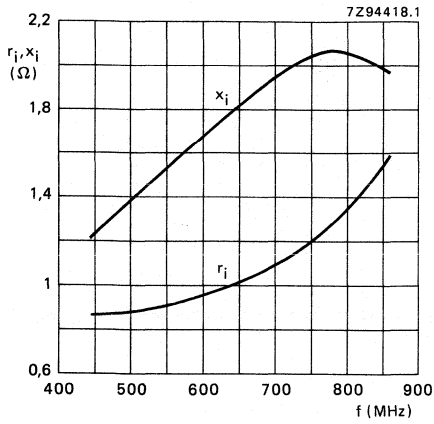


Fig. 10 Input impedance (series components).

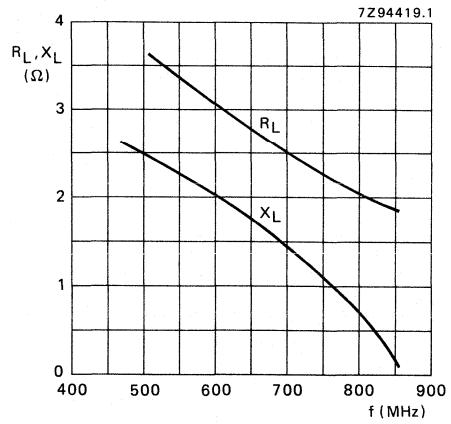


Fig. 11 Load impedance (series components).

Conditions for Figs 10, 11 and 12

Typical values;  $V_{CE} = 25$  V;  $P_L = 30$  W;  $f = 470$  to 860 MHz;  $T_h = 25$  °C;  
 $R_{th\ mb-h} = 0,4$  K/W;  $I_{C(ZS)} = 60$  mA; class-AB operation.

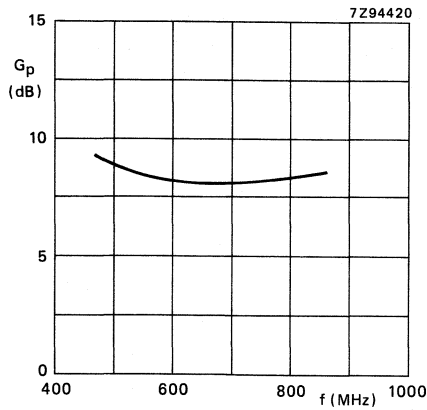


Fig. 12 Power gain versus frequency.





## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in mobile radio transmitters in the 175 MHz communications band.

### Features

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability
- internal matching to achieve an optimum wideband capability and high power gain

The transistor has a 6-lead flange envelope with a ceramic cap (SOT-119). All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	175	75	> 6,5	> 55

### MECHANICAL DATA

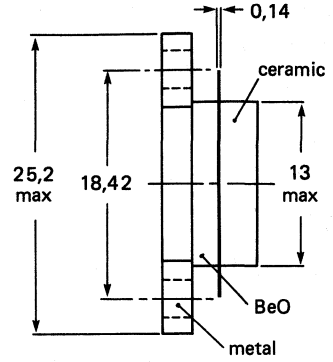
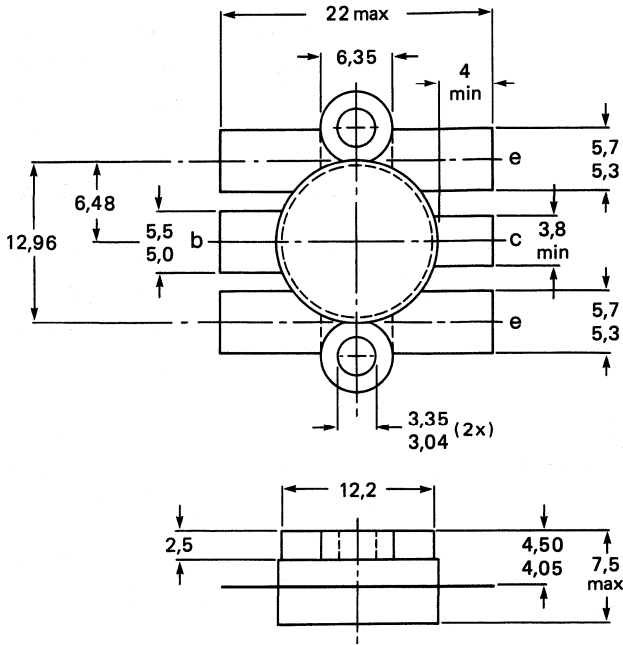
Fig. 1 SOT-119 (see Fig. 1)

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**MECHANICAL DATA**

Fig. 1 SOT-119.

Dimensions in mm



7Z77385.6

Torque on screw: min. 0,6 Nm (6 kg.cm)  
max. 0,75 Nm (7,5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16,5 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average	$I_C$	max.	15 A
peak value; $f > 1$ MHz	$I_{CM}$	max.	45 A
Total power dissipation at $T_{mb} = 25\text{ }^\circ\text{C}$ ; $f > 1$ MHz	$P_{tot}$	max.	150 W
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Operating junction temperature	$T_j$	max.	200 $^\circ\text{C}$

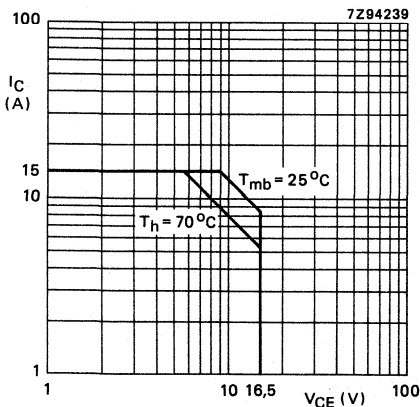


Fig. 2 D.C. soar.  
 $R_{th\ mb-h} = 0,2\ \text{K/W}$ .

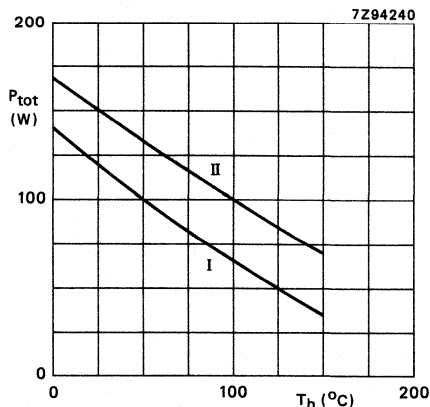


Fig. 3 Power/temperature derating curves;  $R_{th\ mb-h} = 0,2\ \text{K/W}$ .  
I Continuous operation ( $f > 1$  MHz)  
II Short-time operation during mismatch; ( $f > 1$  MHz).

**THERMAL RESISTANCE**

Dissipation = 96 W;  $T_{mb} = 25\text{ }^\circ\text{C}$

From junction to mounting base  
(r.f. operation)

$R_{th\ j-mb} = 1,05\ \text{K/W}$

From mounting base to heatsink

$R_{th\ mb-h} = 0,2\ \text{K/W}$

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 100\text{ mA}$

$V_{(BR)CBO}$  min. 36 V

Collector-emitter breakdown voltage  
open base;  $I_C = 200\text{ mA}$

$V_{(BR)CEO}$  min. 16,5 V

Emitter-base breakdown voltage  
open collector;  $I_E = 20\text{ mA}$

$V_{(BR)EBO}$  min. 4 V

Collector cut-off current  
 $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

$I_{CES}$  max. 44 mA

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$E_{SBR}$  min. 20 mJ

D.C. current gain  
 $V_{CE} = 10\text{ V}$ ;  $I_C = 10\text{ A}$

$h_{FE}$  min. 15  
typ. 55

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

$C_c$  typ. 240 pF

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0$ ;  $V_{CE} = 12,5\text{ V}$

$C_{re}$  typ. 150 pF

Collector-flange capacitance

$C_{cf}$  typ. 3 pF

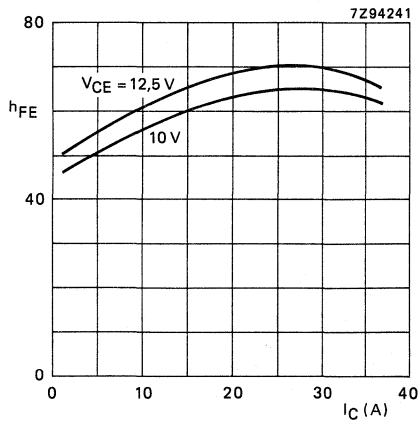


Fig. 4 D.C. current gain versus collector current;  $T_j = 25\text{ }^\circ\text{C}$ .

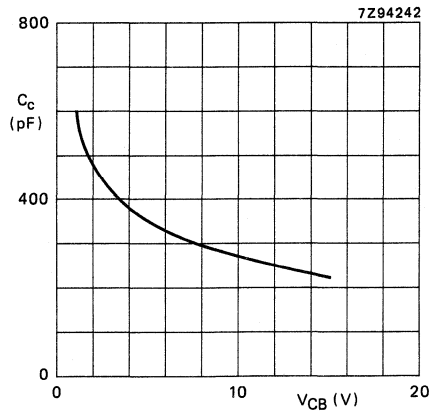


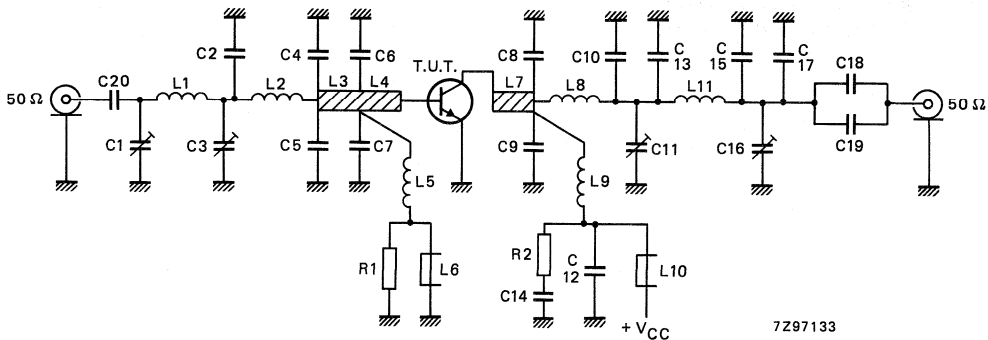
Fig. 5 Output capacitance versus  $V_{CB}$ ;  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION

R.F. performance in c.w. operation (common-emitter circuit; class-B)

 $f = 175 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0,2 \text{ K/W}$ 

mode of operation	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	75	> 6,5 typ. 7,5	> 55 typ. 63

Fig. 6 Class-B test circuit at  $f = 175 \text{ MHz}$ .

## List of components:

- C1 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)
- C2 = 10 pF multilayer ceramic chip capacitor\*
- C3 = C16 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)
- C4 = C5 = 75 pF multilayer ceramic chip capacitor
- C6 = C7 = 100 pF multilayer ceramic chip capacitor\*
- C8 = C9 = 2 x 75 pF multilayer ceramic chip capacitors\* in parallel
- C10 = C13 = 39 pF multilayer ceramic chip capacitor\*
- C11 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)
- C12 = 2 x 820 pF multilayer ceramic chip capacitors in parallel\*
- C14 = 100 nF polyester capacitor
- C15 = C17 = 12 pF multilayer ceramic chip capacitor\*
- C18 = C19 = 470 pF multilayer ceramic chip capacitor\*
- C20 = 820 pF multilayer ceramic chip capacitor\*

\* American Technical Ceramics capacitor type 100B or capacitor of the same quality.

- L1 = 1 turn silver-plated Cu-wire (2,0 mm); int. dia. 10 mm; leads 2 x 4 mm
  - L2 = 1 turn silver-plated Cu-wire (2,0 mm); int. dia. 1 mm; leads 2 x 6 mm
  - L3 = strip (14 mm x 6 mm)
  - L4 = strip (8 mm x 6 mm)
  - L5 = 100 nH, 7 turns closely wound enamelled Cu-wire (0,5 mm); int. dia. 3 mm; leads 2 x 7 mm
  - L6 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36640)
  - L7 = strip (12 mm x 6 mm)
  - L8 = silver-plated copper U-shaped inductance (7 + 15 + 7) mm x 4 mm x 0,5 mm
  - L9 = silver-plated copper U-shaped inductance (8 + 8,5 + 6) mm x 4 mm x 0,5 mm
  - L10 = modified Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36640) with 3 parallel connected Cu wires (0,8 mm)
  - L11 = 2 turns silver-plated Cu-wire (2,0 mm); int. dia. 9 mm; length 7,5 mm; leads 2 x 3,5 mm
- L3, L4 and L7 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, ( $\epsilon_r = 4,5$ ) thickness 1/16 inch).
- R1 =  $10 \Omega \pm 10\%$ , carbon resistor
  - R2 =  $4,7 \Omega \pm 10\%$ , carbon resistor

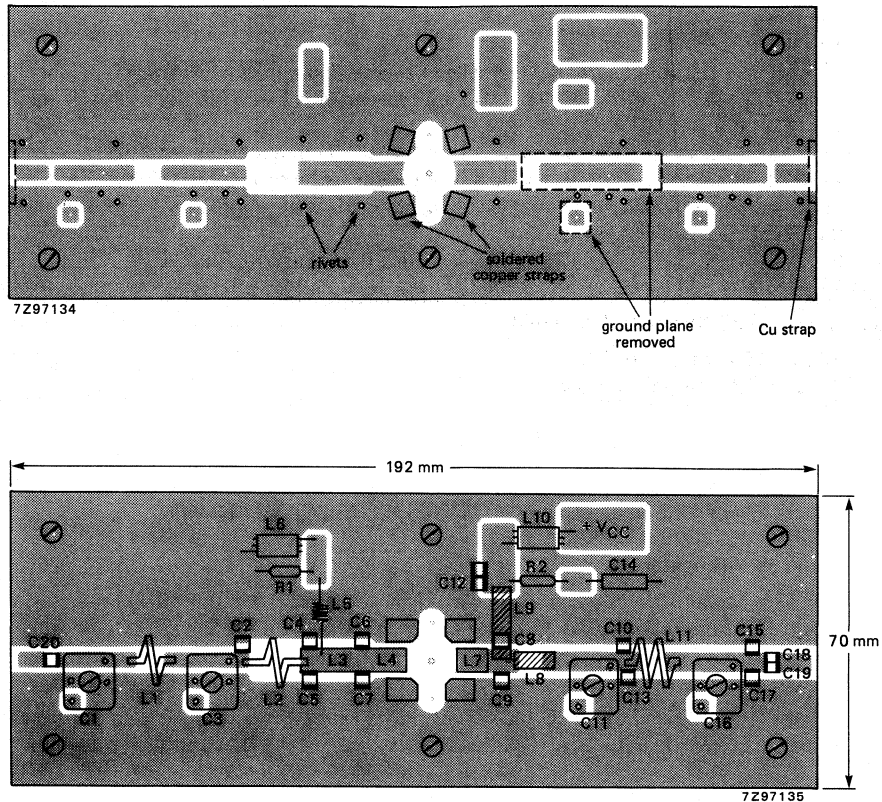


Fig. 7 Printed circuit board and component lay-out for 175 MHz class-B test circuit.

The circuit and components are on one side of the epoxy fibre-glass board. The other side, except for the area indicated by the dotted line, is unetched copper serving as a ground plane.

If the p.c.b. is in direct contact with the heatsink, the heatsink area within the dotted line has to be raised at least 0,5 mm to minimize the dielectric losses.

Earth connections are made by hollow rivets and additionally by fixing screws and copper straps under the emitters to provide a direct contact between the copper of the component side and the ground plane.

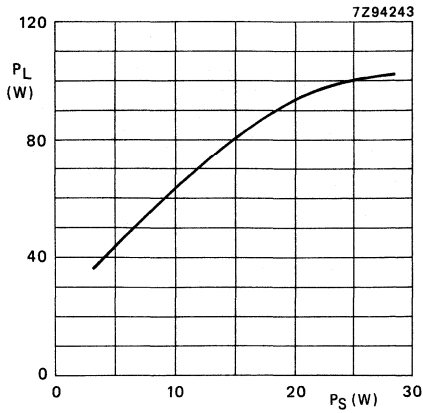


Fig. 8 Load power versus source power.

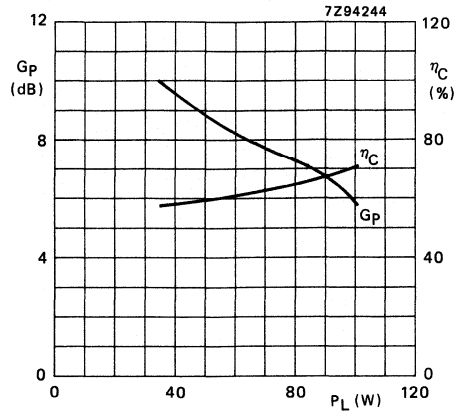


Fig. 9 Power gain and efficiency versus load power.

Condition for Figs 8 and 9:

Typical values;  $V_{CE} = 12,5 \text{ V}$ ;  $f = 175 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0,2 \text{ K/W}$ .

**Ruggedness in class-B operation**

The BLV75/12 is capable of withstanding a load mismatch (VSWR = 20 through all phases) at rated load power up to a supply voltage of 12,5 V;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0,2 \text{ K/W}$ .

**Power slump**

If  $T_h$  is increased from 25  $^\circ\text{C}$  to 70  $^\circ\text{C}$  the output power slump for constant  $P_S$  amounts to typ. 7% ( $V_{CE} = 12,5$ ;  $f = 175 \text{ MHz}$ ;  $R_{th\text{ mb-h}} = 0,2 \text{ K/W}$ ).



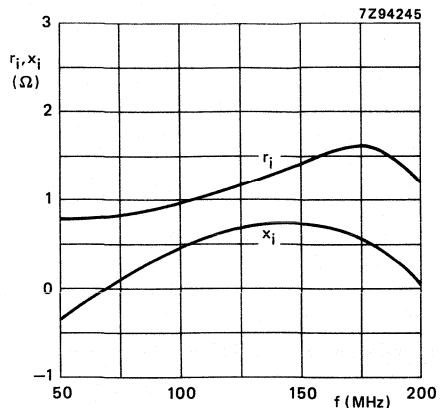


Fig. 10 Input impedance (series components).

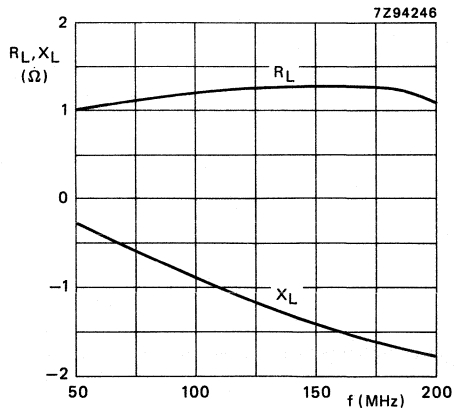


Fig. 11 Load impedance (series components).

Conditions for Figs 10, 11 and 12:

Typical values;  $V_{CE} = 12,5 \text{ V}$ ;  $P_L = 75 \text{ W}$ ;  $f = 50 \text{ to } 200 \text{ MHz}$ ; class-B operation;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

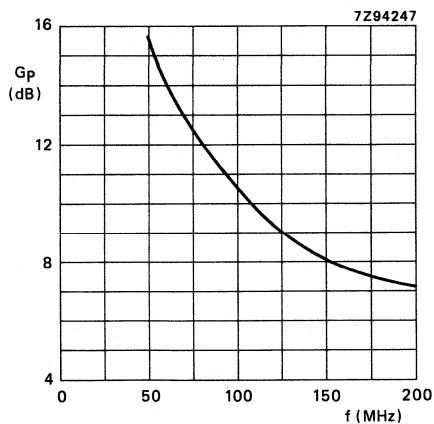


Fig. 12 Power gain versus frequency.

10/10/10

### RESEARCH PROPOSAL

The purpose of this research is to investigate the effects of climate change on the environment.

The research will be conducted in a laboratory setting using a controlled environment.

The results of this research will be used to inform policy and practice.

The research will be conducted over a period of 12 months.

The research will be funded by the National Science Foundation.

The research will be published in a peer-reviewed journal.

The research will be available to the public through an open access repository.

The research will be conducted in accordance with the highest standards of research ethics.

The research will be conducted in a safe and secure environment.

The research will be conducted in a timely and efficient manner.

The research will be conducted in a professional and ethical manner.

The research will be conducted in a transparent and accountable manner.

## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in base stations in the v.h.f. mobile radio band.

### Features:

- multi-base structure and diffused emitter ballasting resistors for an optimum temperature profile;
- gold metallization ensures excellent reliability.

The transistor has a 1/2 in. 4-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$P_S$ W	$G_p$ dB	$\eta$ %
narrow band; c.w.	28	175	80	< 17,9	> 6,5	> 70

### MECHANICAL DATA

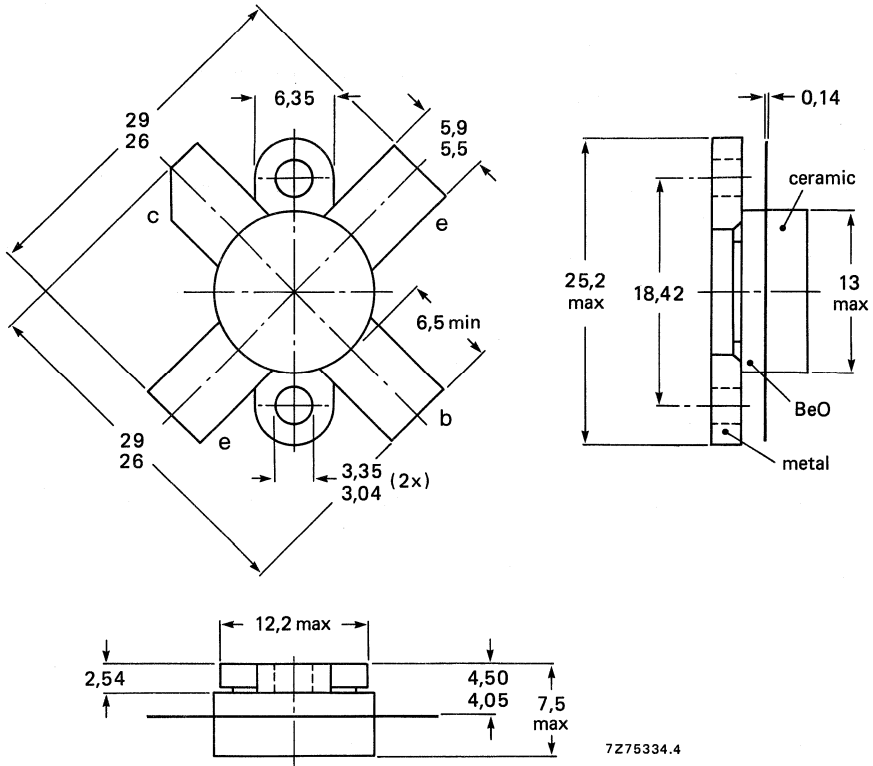
SOT-121 (see Fig. 1)

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-121.

Dimensions in mm



Torque on screw: min. 0,60 Nm (6,0 kg cm)  
 max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak-value);

$V_{BE} = 0$

open base

Emitter-base voltage (open collector)

Collector current

d.c. or average

(peak value);  $f > 1$  MHz

Total power dissipation at  $T_{mb} = 25$  °C

R.F. power dissipation

$f > 1$  MHz;  $T_{mb} = 25$  °C

$f > 1$  MHz;  $T_h = 70$  °C

Storage temperature

Operating junction temperature

$V_{CESM}$  max. 65 V

$V_{CEO}$  max. 33 V

$V_{EBO}$  max. 4 V

$I_C; I_{C(AV)}$  max. 8,5 A

$I_{CM}$  max. 17,5 A

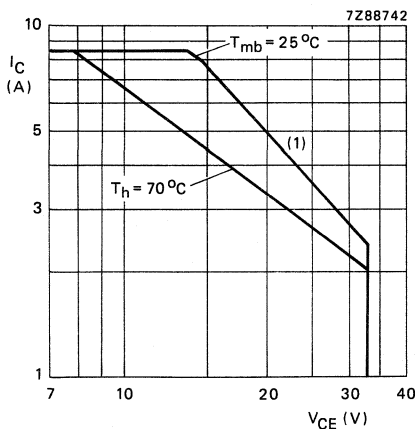
$P_{tot}$  max. 116 W

$P_{rf}$  max. 144 W

$P_{rf}$  max. 80 W

$T_{stg}$  -65 to +150 °C

$T_j$  max. 200 °C



(1) Second breakdown limit.

Fig. 2 D.C. SOAR.

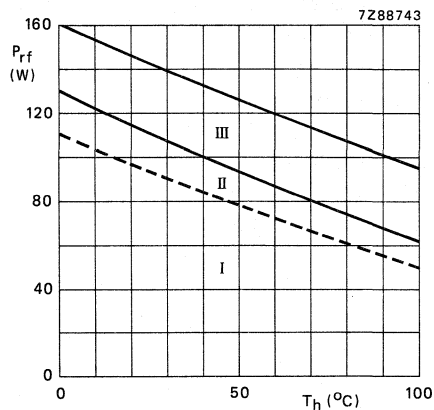


Fig. 3 Power derating curve vs. temperature.

- I Continuous d.c. operation
- II Continuous r.f. operation; ( $f > 1$  MHz)
- III Short-time operation during mismatch; ( $f > 1$  MHz)

**THERMAL RESISTANCE** (dissipation = 90 W;  $T_{mb} = 60$  °C, i.e.  $T_h = 33$  °C)

From junction to mounting base  
(d.c. dissipation)

$R_{th j-mb(dc)}$  = 1,50 K/W

From junction to mounting base  
(r.f. dissipation)

$R_{th j-mb(rf)}$  = 1,30 K/W

From mounting base to heatsink

$R_{th mb-h}$  = 0,3 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 25\text{ mA}$ open base;  $I_C = 100\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$  $V_{(BR)CEO} > 33\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 33\text{ V}$  $I_{CES} < 10\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 10\text{ mJ}$  $R_{BE} = 10\ \Omega$  $E_{SBR} > 10\text{ mJ}$ 

D.C. current gain\*

 $I_C = 3,5\text{ A}; V_{CE} = 25\text{ V}$  $h_{FE}$  typ. 45  
15 to 100

Collector-emitter saturation voltage\*

 $I_C = 10\text{ A}; I_B = 2\text{ A}$  $V_{CEsat}$  typ. 1,6 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 3,5\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 575 MHz $-I_E = 10\text{ A}; V_{CB} = 25\text{ V}$  $f_T$  typ. 600 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 25\text{ V}$  $C_c$  typ. 155 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 50\text{ mA}; V_{CE} = 25\text{ V}$  $C_{re}$  typ. 88 pF

Collector-flange capacitance

 $C_{cf}$  typ. 4,5 pF\* Measured under pulse conditions:  $t_p > 300\ \mu\text{s}; \delta < 0,02$ .

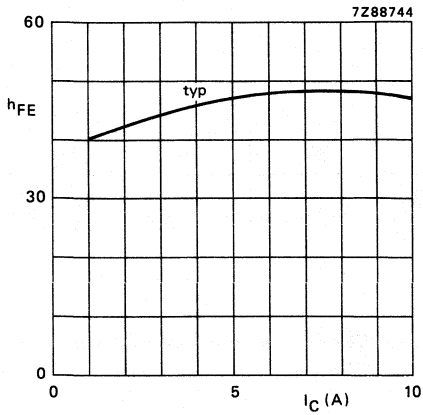


Fig. 4  $V_{CE} = 25$  V;  $T_j = 25$  °C.

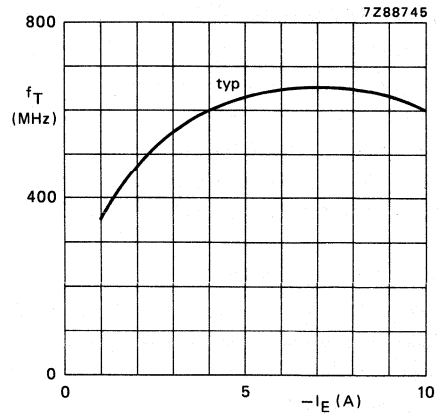


Fig. 5  $V_{CB} = 25$  V;  $f = 100$  MHz;  
 $T_j = 25$  °C.

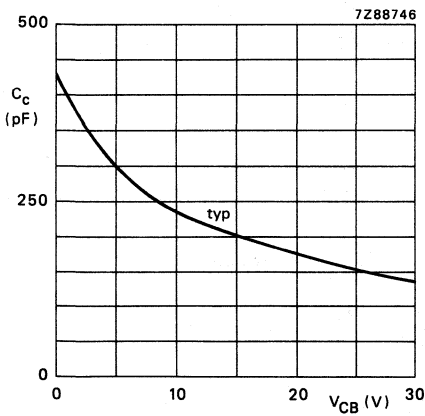


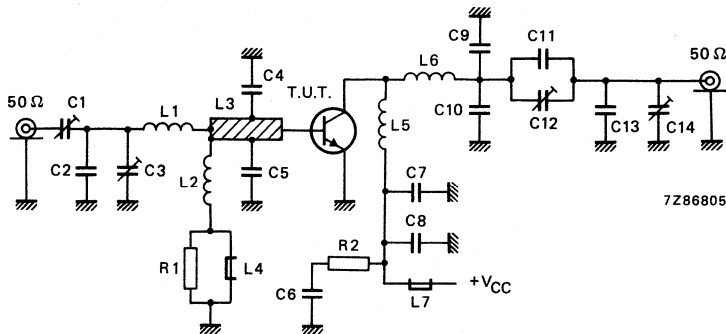
Fig. 6  $I_E = I_e = 0$ ;  $f = 1$  MHz;  
 $T_j = 25$  °C.

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter class-B circuit)

 $f = 175 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ 

mode of operation	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta$ %
narrow band; c.w.	28	80	< 17,9 typ. 16,0	> 6,5 typ. 7,0	< 4,1 typ. 3,8	> 70 typ. 75

Fig. 7 Class-B test circuit at  $f = 175 \text{ MHz}$ .

List of components:

C1 = C12 = C14 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C2 = 30 pF (500 V) multilayer ceramic chip capacitor\*

C3 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C4 = C5 = 56 pF (500 V) multilayer ceramic chip capacitor\*

C6 = 100 nF (50 V) multilayer ceramic chip capacitor

C7 = C8 = 220 pF (50 V) multilayer ceramic chip capacitor

C9 = C10 = 10 pF (500 V) multilayer ceramic chip capacitor\*

C11 = 24 pF (500 V) multilayer ceramic chip capacitor\*

C13 = 13 pF (500 V) multilayer ceramic chip capacitor\*

L1 = Cu wire (1,8 mm); length 15 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 7 mm

L3 = strip (15 mm x 8 mm); taps for C4 and C5 at 7 mm from transistor edge

L4 = L7 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L5 = 1 turn Cu wire (1,8 mm); int. dia. 9 mm; leads 2 x 10 mm

L6 = 1/2 turn Cu wire (1,8 mm); int. dia. 13 mm; leads 2 x 5 mm

L3 is a strip on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16 in.

R1 = R2 = 10  $\Omega$  ( $\pm 10\%$ ) carbon resistor (0,25 W)

\* American Technical Ceramics capacitors or capacitors of same quality.



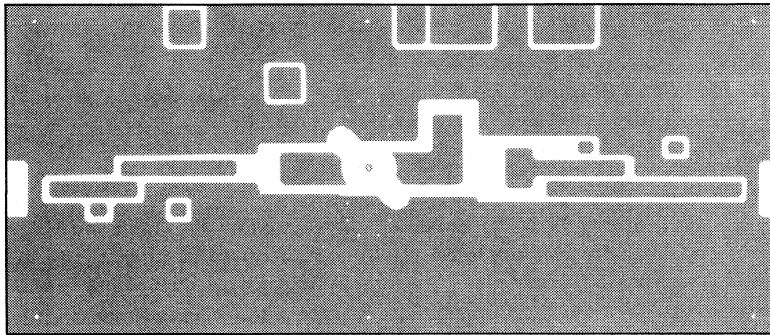
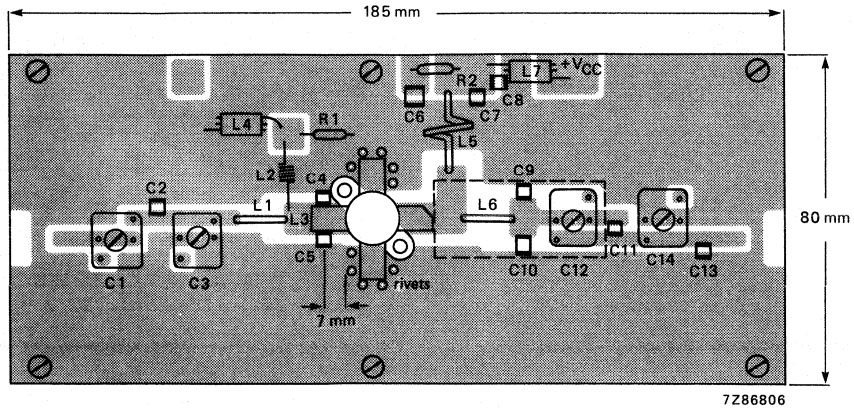


Fig. 8 Component layout and printed-circuit board for 175 MHz.

The circuit and the components are on one side of the epoxy fibre-glass board, the other side is unetched copper to serve as ground-plane. Earth connections are made by hollow rivets and additionally by fixing screws and copper straps at the input and output to provide direct contact between the copper on the component side and the ground-plane.

To minimize the dielectric losses, the ground-plane under the interconnections of L6, C9, C10, C11 and C12 has been removed.

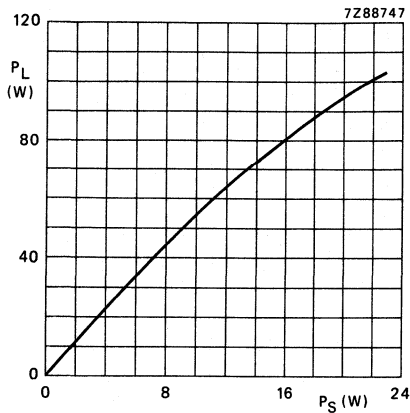


Fig. 9 Load power as a function of source power.

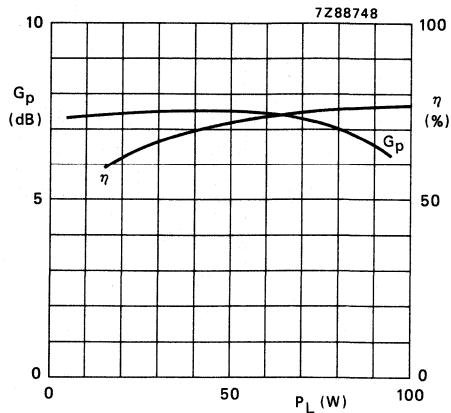


Fig. 10 Power gain and efficiency as a function of load power.

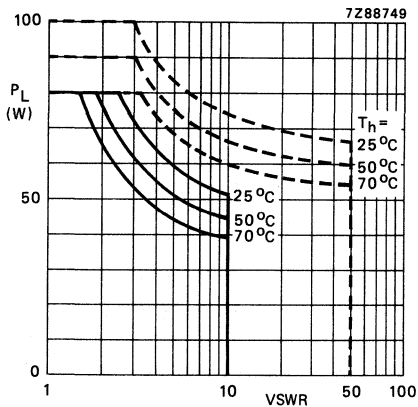


Fig. 11 R.F. SOAR at  $V_{CE} = 28$  V.  
 —  $f > 1$  MHz (continuous);  
 - - - short time operation during mismatch ( $f > 1$  MHz).

Conditions for Figs 9 and 10:  
 Test circuit tuned for each power level;  
 typical values;  $V_{CE} = 28$  V;  $f = 175$  MHz;  
 $T_h = 25$  °C; class-B operation.

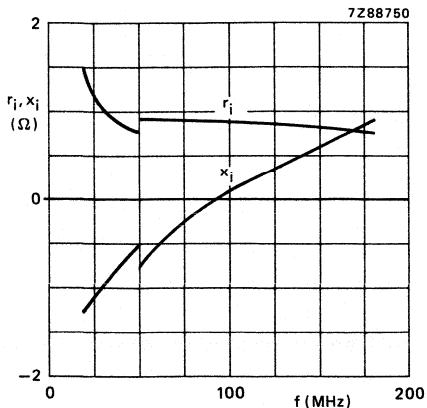


Fig. 12 Input impedance (series components).

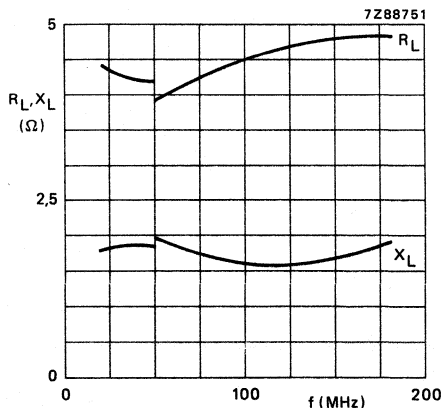


Fig. 13 Load impedance (series components).

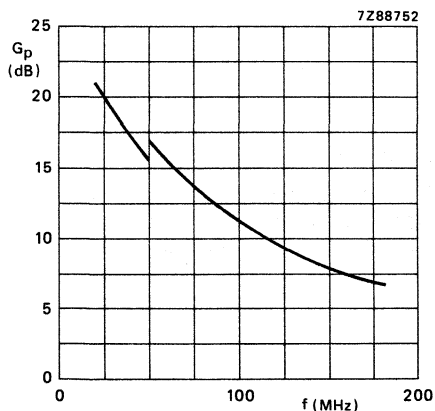


Fig. 14 Power gain as a function of frequency.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 28 \text{ V}$ ;  $P_L = 80 \text{ W}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation.

OPERATING NOTE for Figs 12, 13 and 14:

Below 50 MHz a base-emitter resistor of  $4,7 \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor designed for use in mobile radio transmitters in the 900 MHz band.

Features:

- diffused emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability.

The transistor has a 4-lead stud envelope with a ceramic cap (SOT-172). All leads are isolated from the stud.

### QUICK REFERENCE DATA

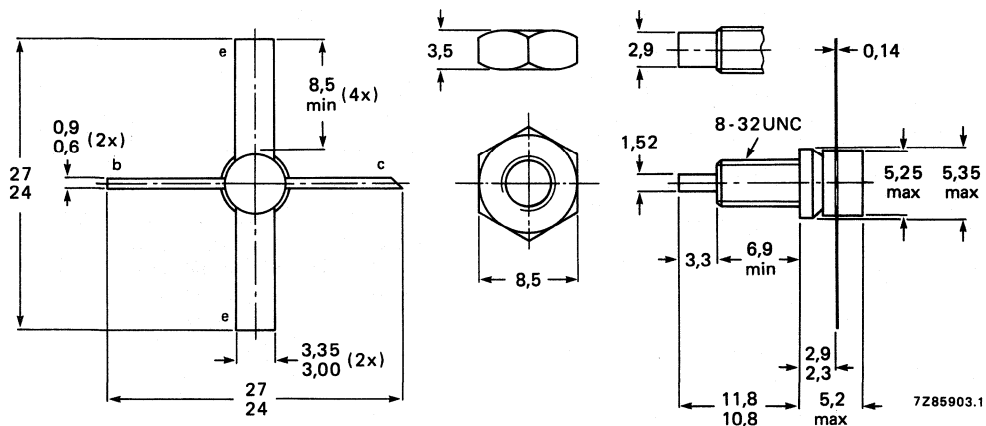
R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5 9,6	900 900	1 0,75	> 7,5 typ. 7,9	> 50 typ. 61

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-172A1.



Torque on nut: min. 0,75 Nm  
(7,5 kg.cm)  
max. 0,85 Nm  
(8,5 kg.cm)

When locking is required an adhesive is preferred instead of a lock washer.

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
Deburring must leave surface flat; do not chamfer or countersink either end of hole.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
d.c. or average	$I_C; I_C(AV)$	max.	0,2 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	0,6 A
D.C. power dissipation			
at $T_{mb} = 115$ °C	$P_{tot(dc)}$	max.	2,25 W
R.F. power dissipation			
$f > 1$ MHz; $T_{mb} = 105$ °C	$P_{tot(rf)}$	max.	3,5 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

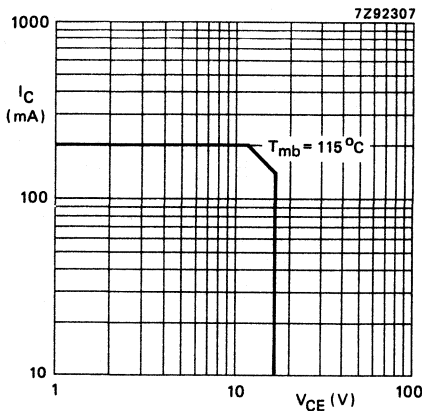


Fig. 2 D.C. SOAR.

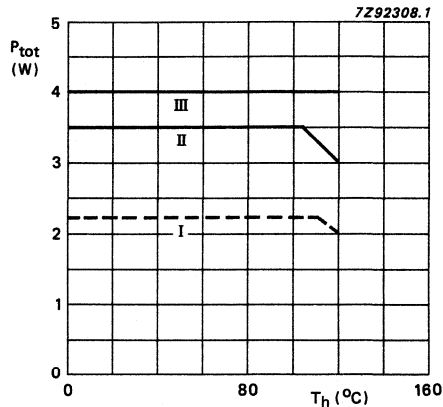


Fig. 3 Power/temperature derating curves.

- I Continuous d.c. operation
- II Continuous r.f. operation ( $f > 1$  MHz)
- III Short-time r.f. operation during mismatch ( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 2,25 W;  $T_{mb} = 25$  °C.

From junction to mounting base  
 (d.c. dissipation)  
 (r.f. dissipation)

$R_{th j-mb(d.c.)}$	max.	25 K/W
$R_{th j-mb(r.f.)}$	max.	19 K/W
$R_{th mb-h}$	max.	0,8 K/W

From mounting base to heatsink

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage, open emitter;  $I_C = 2,5\text{ mA}$

Collector-emitter breakdown voltage, open base;  $I_C = 10\text{ mA}$

Emitter-base breakdown voltage, open collector;  $I_E = 0,5\text{ mA}$

Collector cut-off current,  $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

Second breakdown energy,  $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

D.C. current gain,  $I_C = 0,15\text{ A}$ ;  $V_{CE} = 10\text{ V}$

Transition frequency at  $f = 500\text{ MHz}^*$ ,  $-I_E = 0,15\text{ A}$ ;  $V_{CB} = 12,5\text{ V}$

$-I_E = 0,5\text{ A}$ ;  $V_{CB} = 12,5\text{ V}$

Collector capacitance at  $f = 1\text{ MHz}$ ,  $I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

Feedback capacitance at  $f = 1\text{ MHz}$ ,  $I_C = 0$ ;  $V_{CE} = 12,5\text{ V}$

Collector-stud capacitance

$V_{(BR)CBO} > 36\text{ V}$

$V_{(BR)CEO} > 16\text{ V}$

$V_{(BR)EBO} > 3\text{ V}$

$I_{CES} < 1\text{ mA}$

$ESBR > 0,3\text{ mJ}$

$h_{FE} > 25$

$f_T$  typ.  $4,8\text{ GHz}$

$f_T$  typ.  $1,4\text{ GHz}$

$C_c$  typ.  $1,8\text{ pF}$

$C_{re}$  typ.  $1,0\text{ pF}$

$C_{cs}$  typ.  $0,5\text{ pF}$

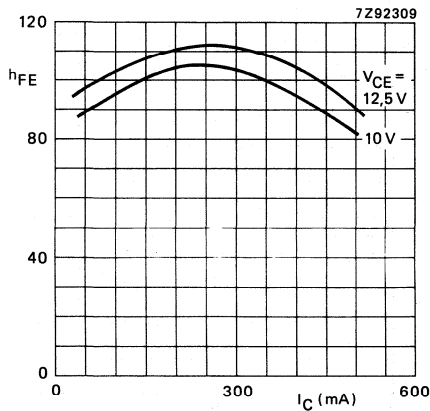


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

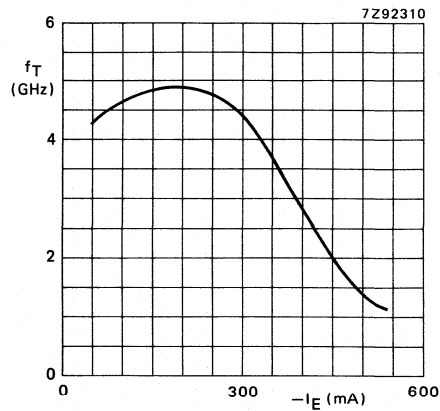


Fig. 5  $V_{CB} = 12,5\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

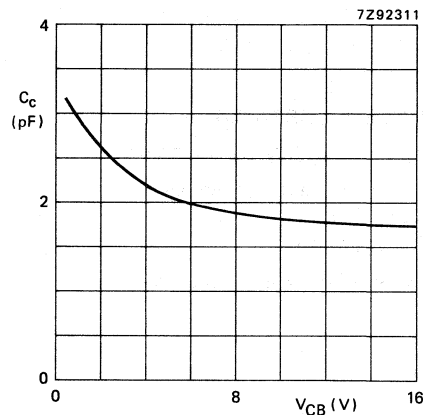


Fig. 6  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

\* Measured under pulse conditions:  $t_p = 50\text{ }\mu\text{s}$ ;  $\delta < 1\%$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class-B):  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

mode of operation	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta_C$ %
narrow band; c.w.	12,5 9,6	1 0,75	< 0,178 typ. 0,126 typ. 0,122	> 7,5 typ. 9,0 typ. 7,9	< 0,160 typ. 0,133 typ. 0,128	> 50 typ. 60 typ. 61

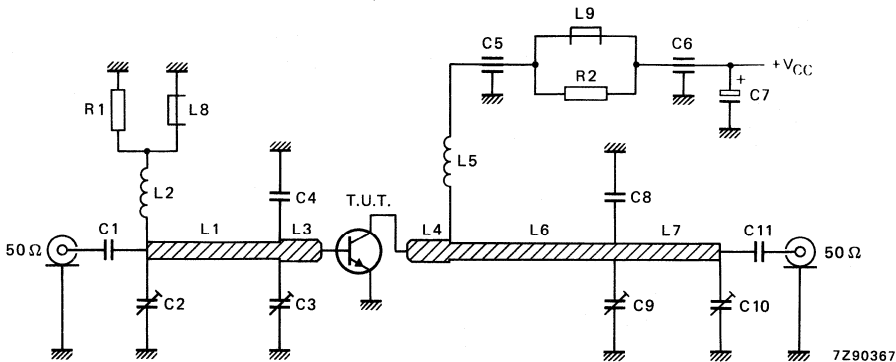


Fig. 7 Class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components:

C1 = C11 = 33 pF multilayer ceramic chip capacitor

C2 = C10 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C3 = C9 = 1,2 to 3,5 pF film dielectric trimmer (cat. no. 2222 809 05001)

C4 = 5,6 pF multilayer ceramic chip capacitor\*

C5 = 10 pF ceramic feed-through capacitor

C6 = 330 pF ceramic feed-through capacitor

C7 = 2,2  $\mu\text{F}$  (35 V) tantalum electrolytic capacitor

C8 = 3,9 pF multilayer ceramic chip capacitor\*

L1 = L7 = 50  $\Omega$  stripline (28,2 mm x 4,0 mm)

L2 = 60 nH; 4 turns closely wound enamelled Cu wire (0,4 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = 38  $\Omega$  stripline (14,6 mm x 6,0 mm)

L4 = 38  $\Omega$  stripline (10,0 mm x 6,0 mm)

L5 = 280 nH; 15 turns closely wound enamelled Cu wire (0,4 mm); int. dia. 3 mm; leads 2 x 5 mm

L6 = 50  $\Omega$  stripline (37,7 mm x 4,0 mm)

L8 = L9 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)

R1 = R2 = 10  $\Omega \pm 10\%$ ; 0,25 W metal film resistor

L1, L3, L4, L6 and L7 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16 inch.

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.



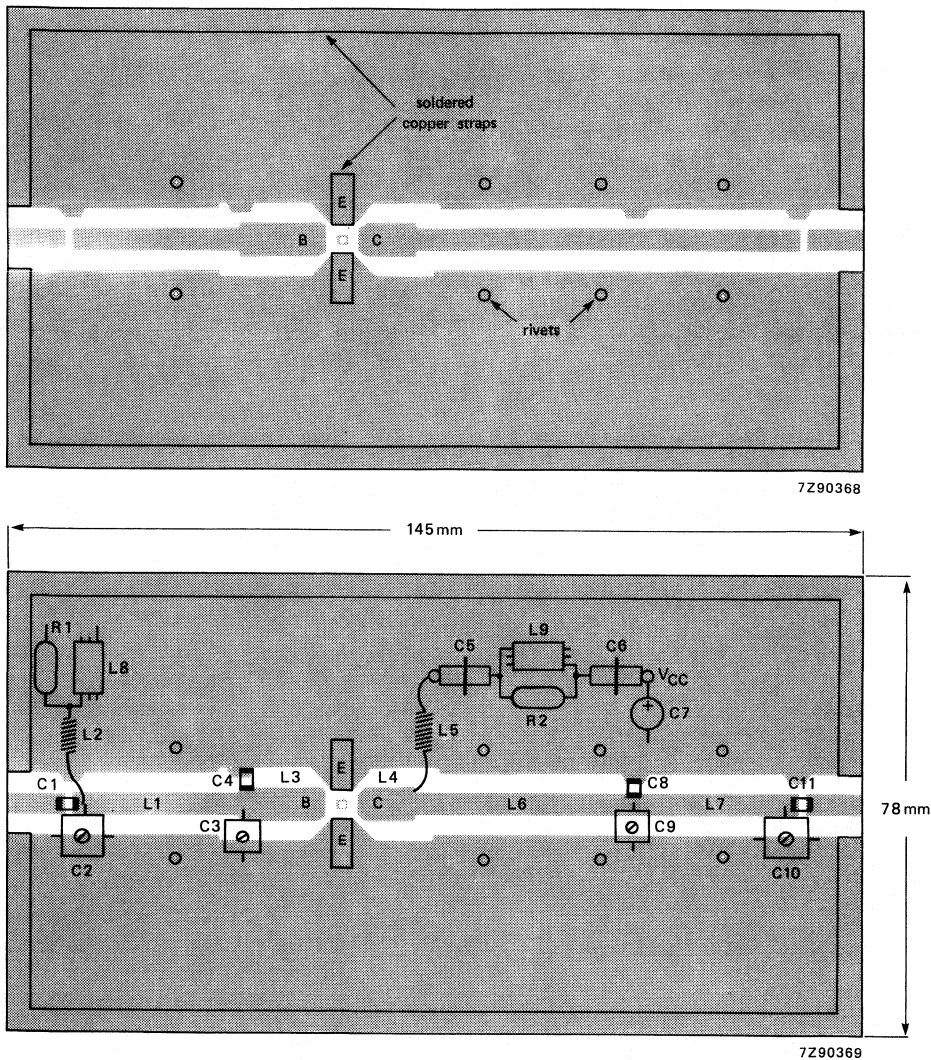


Fig. 8 Printed circuit board and component lay-out for 900 MHz class-B test circuit.

#### Note

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as ground plane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the ground plane.

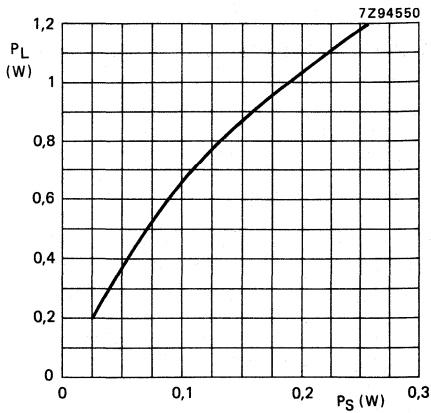


Fig. 9 Load power vs. source power.

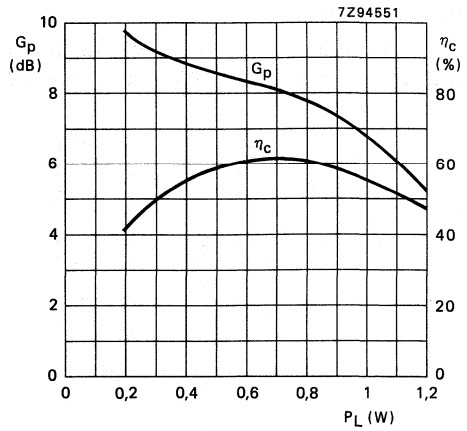


Fig. 10 Power gain and efficiency vs. load power.

Conditions for Figs 9 and 10:

$V_{CE} = 9,6$  V;  $f = 900$  MHz;  $T_h = 25$  °C; class-B operation; typical values.

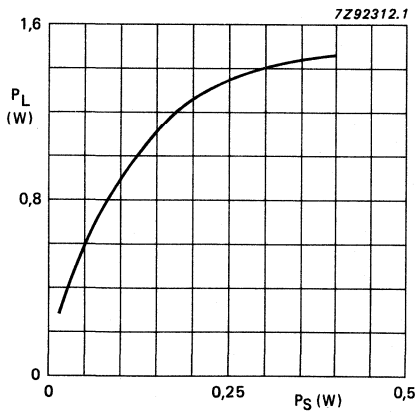


Fig. 11 Input impedance (series components).

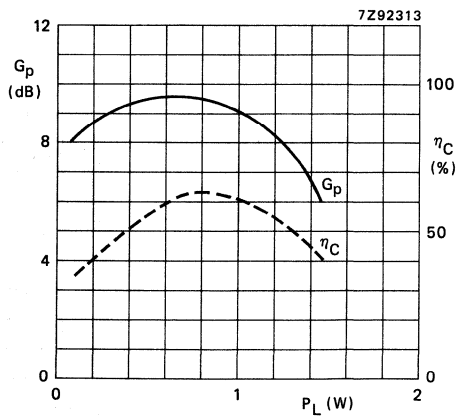


Fig. 12 Load impedance (series components).

Conditions for Figs 11 and 12:

$V_{CE} = 12,5$  V;  $P_L = 1$  W;  $f = 900$  MHz;  $T_h = 25$  °C; class-B operation; typical values.

**RUGGEDNESS**

The device is capable to withstand a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 15,5 V at  $T_h = 25\text{ }^\circ\text{C}$ .

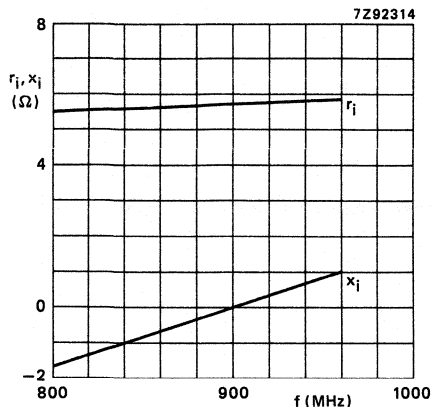


Fig. 13 Input impedance (series components).

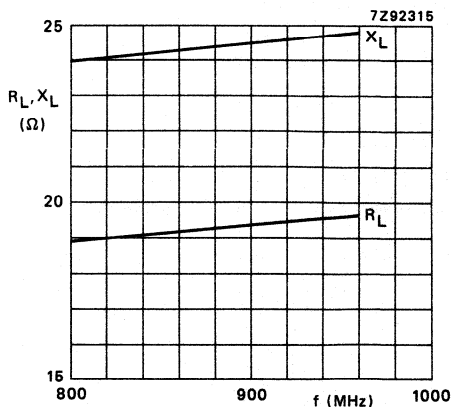


Fig. 14 Load impedance (series components).

Conditions for Figs 13 and 14:

$V_{CE} = 12,5\text{ V}$ ;  $P_L = 1\text{ W}$ ;  $f = 800\text{--}960\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.

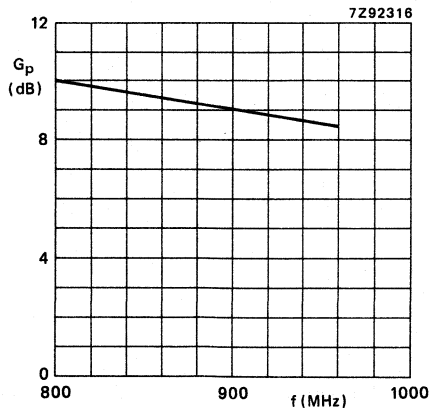


Fig. 15 Power gain vs. frequency.

$V_{CE} = 12,5\text{ V}$ ;  $P_L = 1\text{ W}$ ;  $f = 800\text{--}960\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.



## UHF POWER TRANSISTOR

NPN silicon planar epitaxial transistor designed for use in mobile radio transmitters in the 900 MHz band.

### Features:

- diffused emitter-ballasting resistors for an optimum temperature profile.
- gold metallization ensures excellent reliability.
- the device can be applied at rated output power without an external heatsink when it is mounted on a printed-circuit board (see Fig. 6).

The transistor has a 4-lead envelope with a ceramic cap (SOT-172D). All leads are isolated from the mounting base.

### QUICK REFERENCE DATA

RF performance at  $T_a = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit.\*

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
Narrow band; CW	12.5	900	1	$> 7.5$	$> 50$
	9.6	900	1	typ. 7.0	typ. 57

\* Device mounted on a printed-circuit board (see Fig. 6).

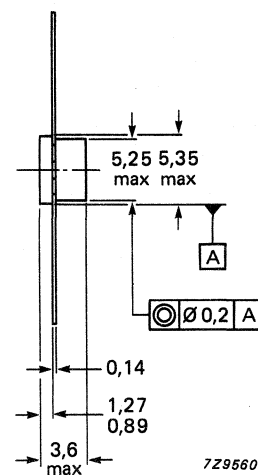
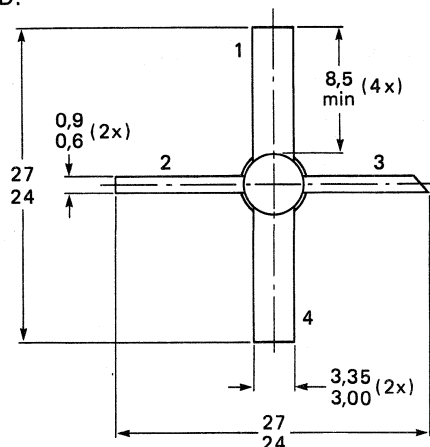
### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-172D.

#### Pinning:

- 1 Emitter
- 2 Base
- 3 Collector
- 4 Emitter



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
DC or average	$I_C; I_C(AV)$	max.	0.2 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	0.6 A
Total power dissipation			
$f > 1$ MHz; $T_{mb} < 105$ °C	$P_{tot}(rf)$	max.	3.5 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

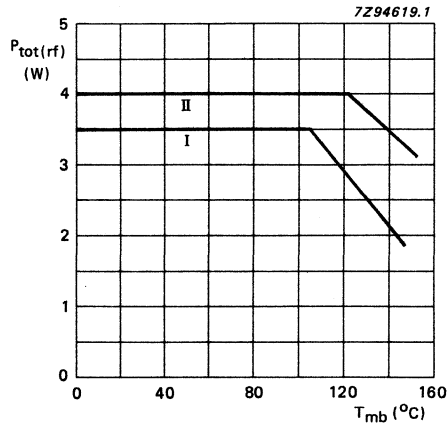


Fig. 2 Power/temperature curve

- I Continuous RF operation ( $f > 1$  MHz)
- II Short-time RF operation during mismatch ( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 2.25 W

From junction to ambient\* ( $f > 1$  MHz)

$T_a = 25$  °C

$R_{th\ j-a}$  (RF) max. 60 K/W

From junction to mounting base

$T_{mb} = 25$  °C ( $f > 1$  MHz)

$R_{th\ j-mb}$  (RF) max. 19 K/W

\* Device mounted on a printed-circuit board (see Fig. 6).

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 2.5\text{ mA}$

$V_{(BR)CBO} > 36\text{ V}$

Collector-emitter breakdown voltage  
open base;  $I_C = 10\text{ mA}$

$V_{(BR)CEO} > 16\text{ V}$

Emitter-base breakdown voltage  
open collector;  $I_E = 0.5\text{ mA}$

$V_{(BR)EBO} > 3\text{ V}$

Collector cut-off current  
 $V_{BE} = 0; V_{CE} = 16\text{ V}$

$I_{CES} < 1\text{ mA}$

Second breakdown energy  
 $L = 25\text{ mH}; f = 50\text{ Hz}; R_{BE} = 10\text{ }\Omega$

$E_{SBR} > 0.3\text{ mJ}$

D.C. current gain  
 $I_C = 0.15\text{ A}; V_{CE} = 10\text{ V}$

$h_{FE} > 25$

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0; V_{CB} = 12.5\text{ V}$

$C_c$  typ.  $1.8\text{ pF}$

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0; V_{CE} = 12.5\text{ V}$

$C_{re}$  typ.  $1.0\text{ pF}$

Collector-mounting base capacitance

$C_{c-mb}$  typ.  $0.5\text{ pF}$

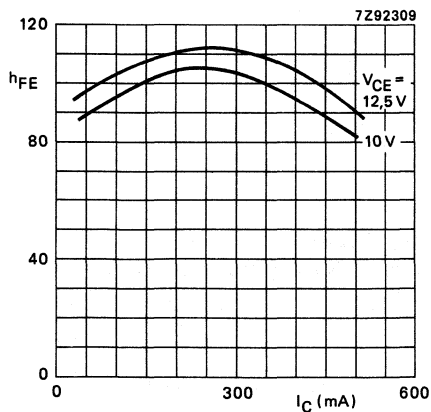


Fig. 3  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

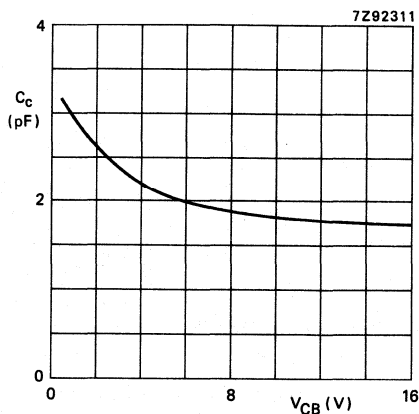
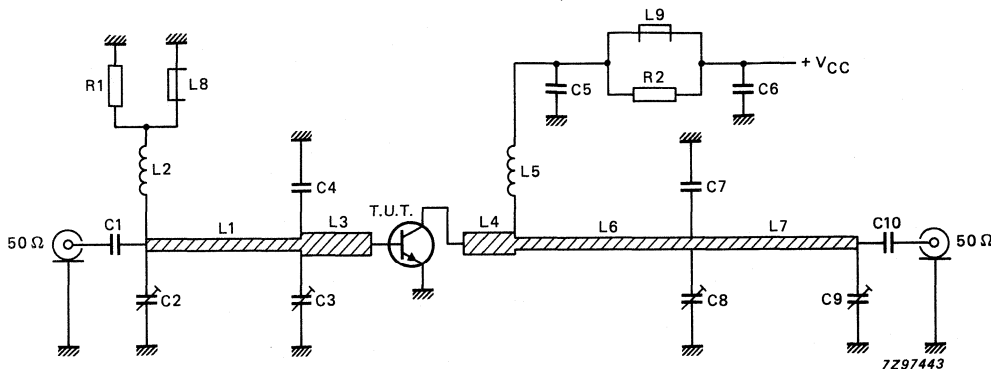


Fig. 4  $I_E = i_e = 0; f = 1\text{ MHz}$ ; typical values.

## APPLICATION INFORMATION

RF performance in CW operation (common-emitter circuit, class-B):  $f = 900 \text{ MHz}$ ;  $T_a = 25 \text{ }^\circ\text{C}$ 

mode of operation	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; CW	12.5	1	> 7.5 typ. 9.0	> 50 typ. 60
	9.6	1	typ. 7.0	typ. 57

Fig. 5 Class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components:

C1 = C10 = 33 pF multilayer ceramic chip capacitor

C2 = C9 = 1.4 to 5.5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C3 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C4 = 5.6 pF multilayer ceramic chip capacitor\*

C5 = 10 pF multilayer ceramic chip capacitor

C6 = 330 pF multilayer ceramic chip capacitor

C7 = 3.9 pF multilayer ceramic chip capacitor\*

C8 = 1.2 to 3.5 pF film dielectric trimmer (cat. no. 2222 809 05001)

L1 = L7 = 50  $\Omega$  stripline (30.8 mm x 2.4 mm)

L2 = 60 nH; 4 turns closely wound enamelled Cu wire (0.4 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = 38  $\Omega$  stripline (16.0 mm x 3.5 mm)L4 = 38  $\Omega$  stripline (11.0 mm x 3.5 mm)

L5 = 280 nH; 15 turns closely wound enamelled Cu wire (0.4 mm); int. dia. 3 mm; leads 2 x 5 mm

L6 = 50  $\Omega$  stripline (41.2 mm x 2.4 mm)

L8 = L9 = Ferroxcube wideband HF choke, grade 3B (cat. no. 4312 020 36642)

R1 = R2 = 10  $\Omega \pm 5\%$ ; 0.25 W metal film resistorL1, L3, L4, L6 and L7 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch; thickness of copper-sheet 2 x 35  $\mu\text{m}$ .

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.

\*\* Device mounted on a printed-circuit board (see Fig. 6).



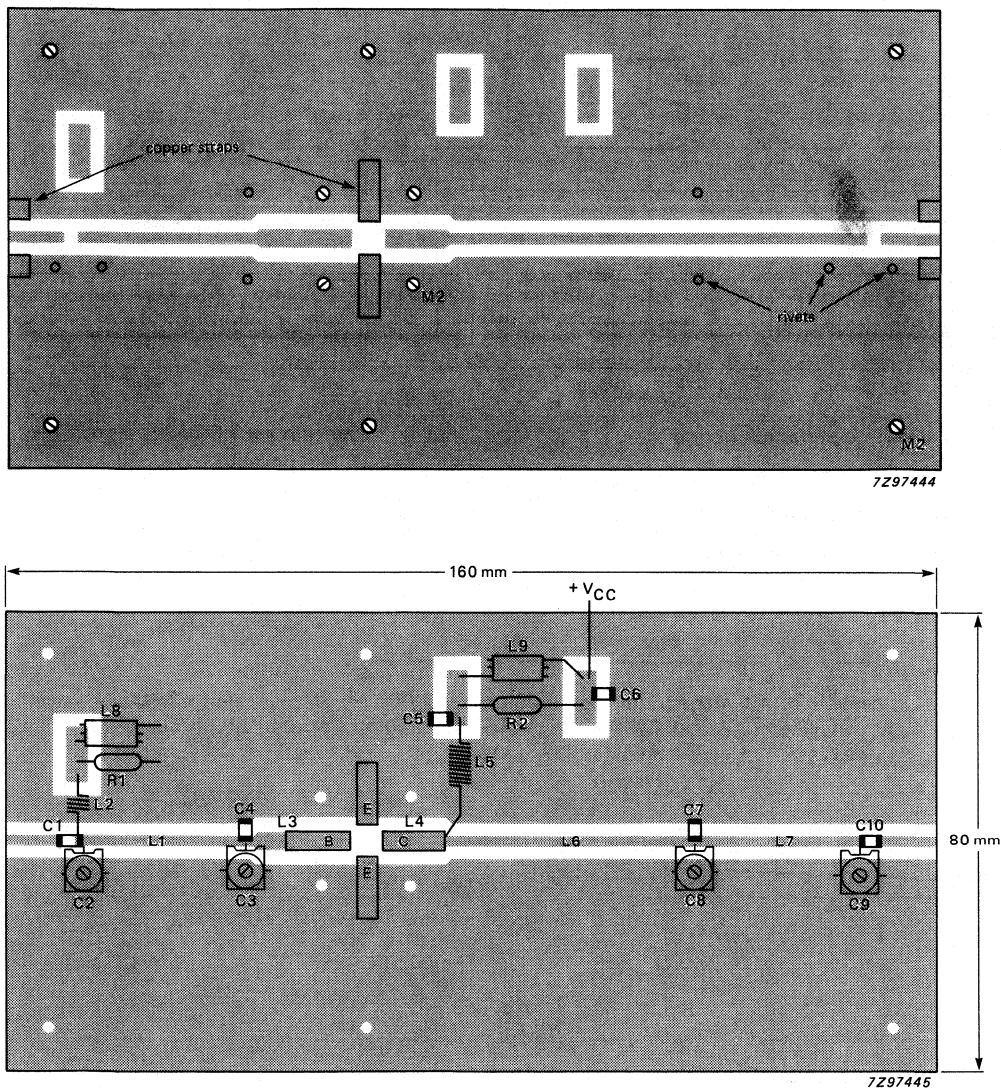


Fig. 6 Printed-circuit board and component lay-out for 900 MHz class-B test circuit.

#### Note

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as groundplane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the groundplane.

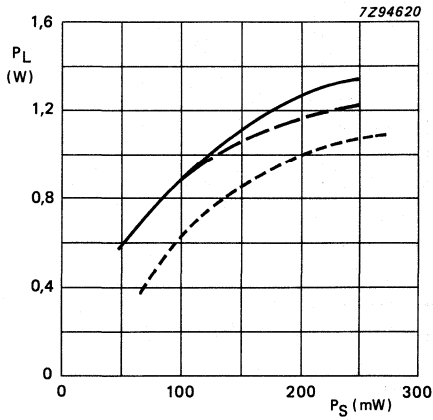


Fig. 7 Load power as a function of source power.

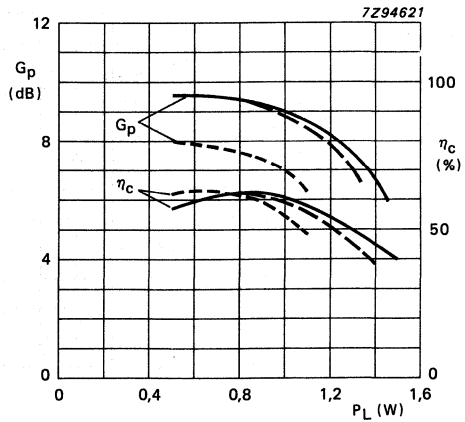


Fig. 8 Power gain and efficiency as a function of load power.

Conditions for Figs 7 and 8:

$f = 900 \text{ MHz}$ ; class-B operation; typical values.

(——  $T_{mb} = 25 \text{ }^\circ\text{C}$ ;  $V_{CE} = 12.5 \text{ V}$ ; - - - -  $T_a = 25 \text{ }^\circ\text{C}$ ;  $V_{CE} = 12.5 \text{ V}$ ; ·····  $T_a = 25 \text{ }^\circ\text{C}$ ;  $V_{CE} = 9.6 \text{ V}$ )

**RUGGEDNESS**

The device is capable to withstand a full load mismatch ( $VSWR = 50$ ; all phases) at rated load power up to a supply voltage of  $15.5 \text{ V}$  at  $T_a = 25 \text{ }^\circ\text{C}$ . Device mounted on a printed circuit board (see Fig. 6).

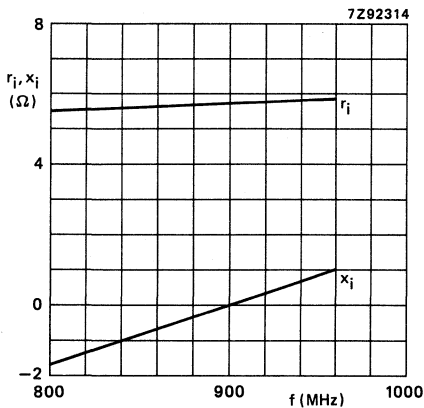


Fig. 9 Input impedance (series components).

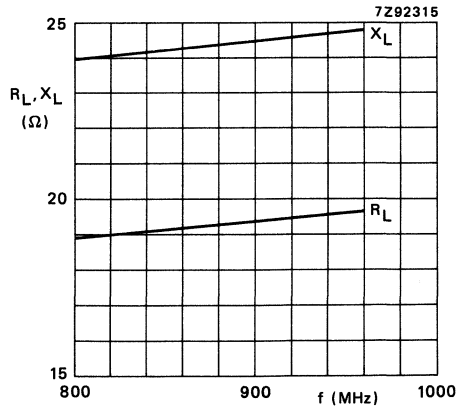


Fig. 10 Load impedance (series components).

Conditions for Figs 9 and 10:

$V_{CE} = 12.5 \text{ V}$ ;  $P_L = 1 \text{ W}$ ;  $f = 800 - 960 \text{ MHz}$ ;  $T_{mb} = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

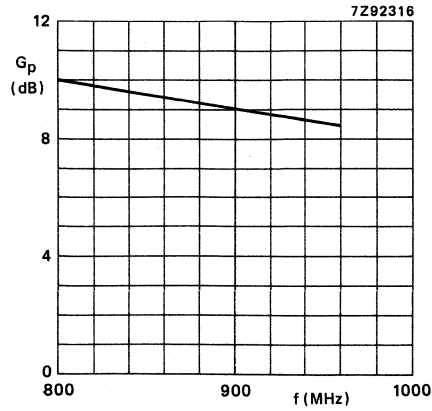


Fig. 11 Power gain as a function of frequency.

$V_{CE} = 12.5 \text{ V}$ ;  $P_L = 1 \text{ W}$ ;  $f = 800 - 960 \text{ MHz}$ ;  $T_{mb} = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor designed for use in mobile radio transmitters in the 900 MHz band.

### Features:

- multi-base structure and diffused emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability.

The transistor has a 4-lead stud envelope with a ceramic cap (SOT-172). All leads are isolated from the stud.

### QUICK REFERENCE DATA

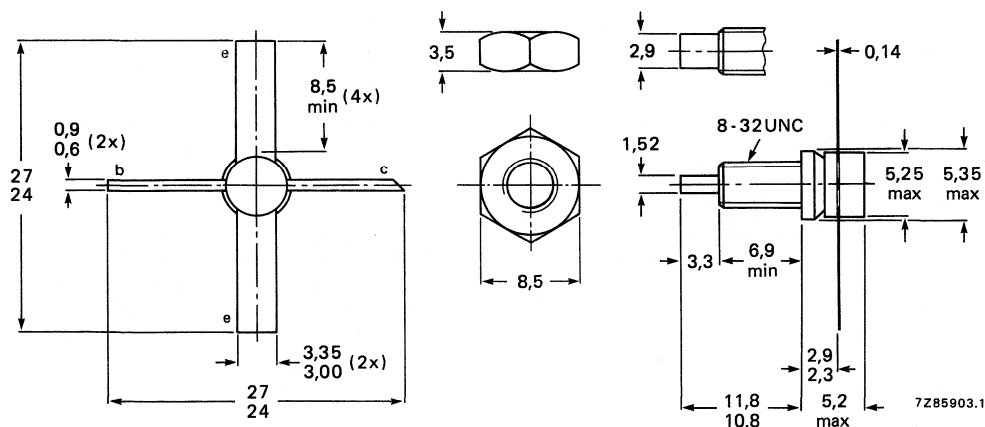
R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5 9,6	900 900	2 1,5	> 6,5 typ. 6,6	> 50 typ. 60

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-172A1.



Torque on nut: min. 0,75 Nm  
(7,5 kg.cm)  
max. 0,85 Nm  
(8,5 kg.cm)

When locking is required an adhesive is preferred instead of a lock washer.

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
Deburring must leave surface flat; donot chamfer or countersink either end of hole.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged. See also page 8.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
d.c. or average	$I_C; I_{C(AV)}$	max.	0,4 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	1,2 A
D.C. power dissipation			
at $T_{mb} = 90$ °C	$P_{tot(dc)}$	max.	4,5 W
R.F. power dissipation			
$f > 1$ MHz; $T_{mb} = 90$ °C	$P_{tot(rf)}$	max.	6 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

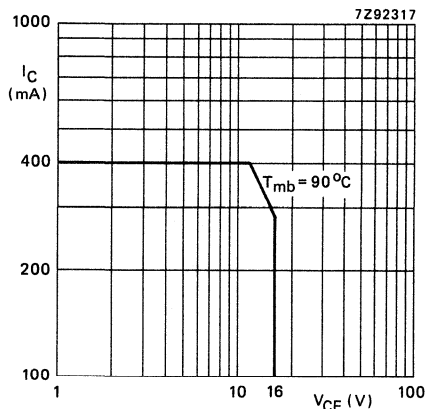


Fig. 2 D.C. SOAR.

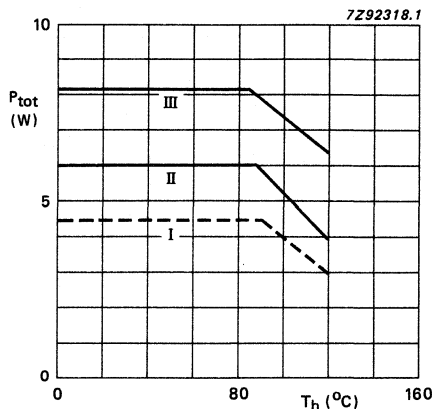


Fig. 3 Power/temperature derating curves  
 I Continuous d.c. operation  
 II Continuous r.f. operation ( $f > 1$  MHz)  
 III Short-time r.f. operation during mismatch ( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 4,5 W;  $T_{mb} = 25$  °C

From junction to mounting base  
 (d.c. dissipation)

$R_{th j-mb(d.c.)}$	max.	20 K/W
$R_{th j-mb(d.c.)}$	max.	15 K/W

From mounting base to heatsink

$R_{th mb-h}$	max.	0,8 K/W
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**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage, open emitter;  $I_C = 5\text{ mA}$

Collector-emitter breakdown voltage, open base;  $I_C = 10\text{ mA}$

Emitter-base breakdown voltage, open collector;  $I_E = 0,5\text{ mA}$

Collector cut-off current,  $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

Second breakdown energy,  $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

D.C. current gain,  $I_C = 0,3\text{ A}$ ;  $V_{CE} = 10\text{ V}$

Transition frequency at  $f = 500\text{ MHz}^*$ ,  $-I_E = 0,3\text{ A}$ ;  $V_{CB} = 12,5\text{ V}$   
 $-I_E = 1,0\text{ A}$ ;  $V_{CB} = 12,5\text{ V}$

Collector capacitance at  $f = 1\text{ MHz}$ ,  $I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

Feed-back capacitance at  $f = 1\text{ MHz}$ ,  $I_C = 0$ ;  $V_{CE} = 12,5\text{ V}$

Collector-stud capacitance

$V_{(BR)CBO}$	>	36 V
$V_{(BR)CEO}$	>	16 V
$V_{(BR)EBO}$	>	3 V
$I_{CES}$	<	2,5 mA
$E_{SBR}$	>	0,55 mJ
$h_{FE}$	>	25
$f_T$	typ.	4 GHz
$f_T$	typ.	1 GHz
$C_c$	typ.	3,5 pF
$C_{re}$	typ.	2,0 pF
$C_{cs}$	typ.	0,5 pF

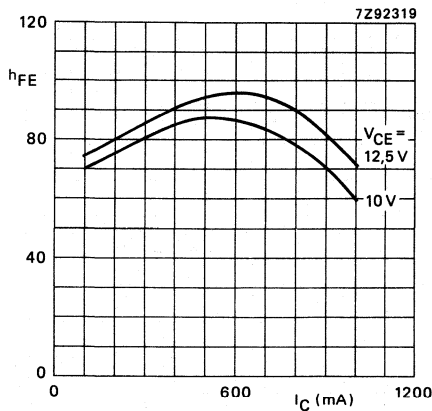


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

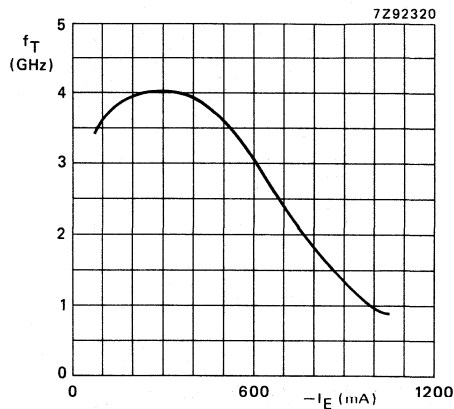


Fig. 5  $V_{CB} = 12,5\text{ V}$ ;  $t_p = 50\text{ }\mu\text{s}$ ;  
 $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

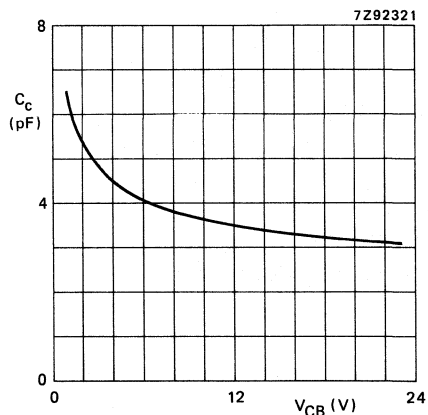


Fig. 6  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

\* Measured under pulse conditions:  $t_p = 50\text{ }\mu\text{s}$ ;  $\delta < 1\%$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class-B):  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

mode of operation	$V_{CE}$	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta_C$ %
narrow band; c.w.	12,5	2	< 0,450 typ. 0,332	> 6,5 typ. 7,8	< 0,320 typ. 0,267	> 50 typ. 60
	9,6	1,5	typ. 0,328	typ. 6,6	typ. 0,260	typ. 60

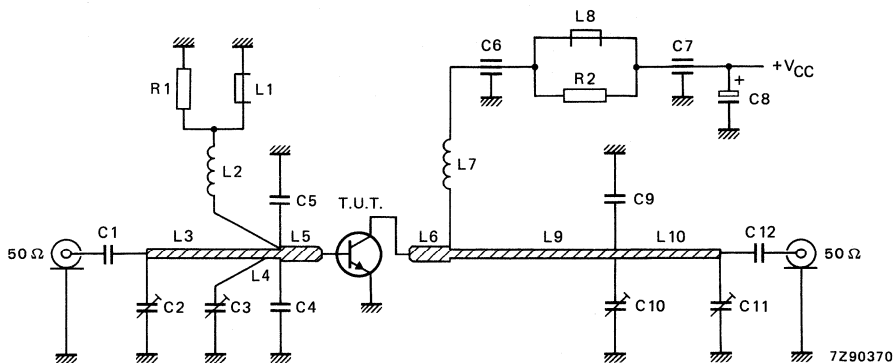


Fig. 7 Class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components:

C1 = C12 = 33 pF multilayer ceramic chip capacitor

C2 = C3 = C11 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C4 = C5 = 5,6 pF multilayer ceramic chip capacitor\*

C6 = 10 pF ceramic feed-through capacitor

C7 = 330 pF ceramic feed-through capacitor

C8 = 2,2  $\mu\text{F}$  (35 V) tantalum electrolytic capacitor

C9 = 3,9 pF multilayer ceramic chip capacitor\*

C10 = 1,2 to 3,5 pF film dielectric trimmer (cat. no. 2222 809 05001)

L1 = L8 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)

L2 = 60 nH; 4 turns closely wound enamelled Cu wire (0,4 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = 50  $\Omega$  stripline (23,3 mm x 1,85 mm)

L4 = 50  $\Omega$  stripline (4,0 mm x 1,85 mm)

L5 = L6 = 29  $\Omega$  stripline (14,0 mm x 4,0 mm)

L7 = 280 nH; 15 turns closely wound enamelled Cu wire (0,4 mm); int. dia. 3 mm; leads 2 x 5 mm

L9 = 50  $\Omega$  stripline (22,7 mm x 1,85 mm)

L10 = 50  $\Omega$  stripline (28,0 mm x 1,85 mm)

R1 = R2 = 10  $\Omega \pm 10\%$ ; 0,25 W metal film resistor

L3, L4, L5, L6, L9 and L10 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/32 inch.

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.



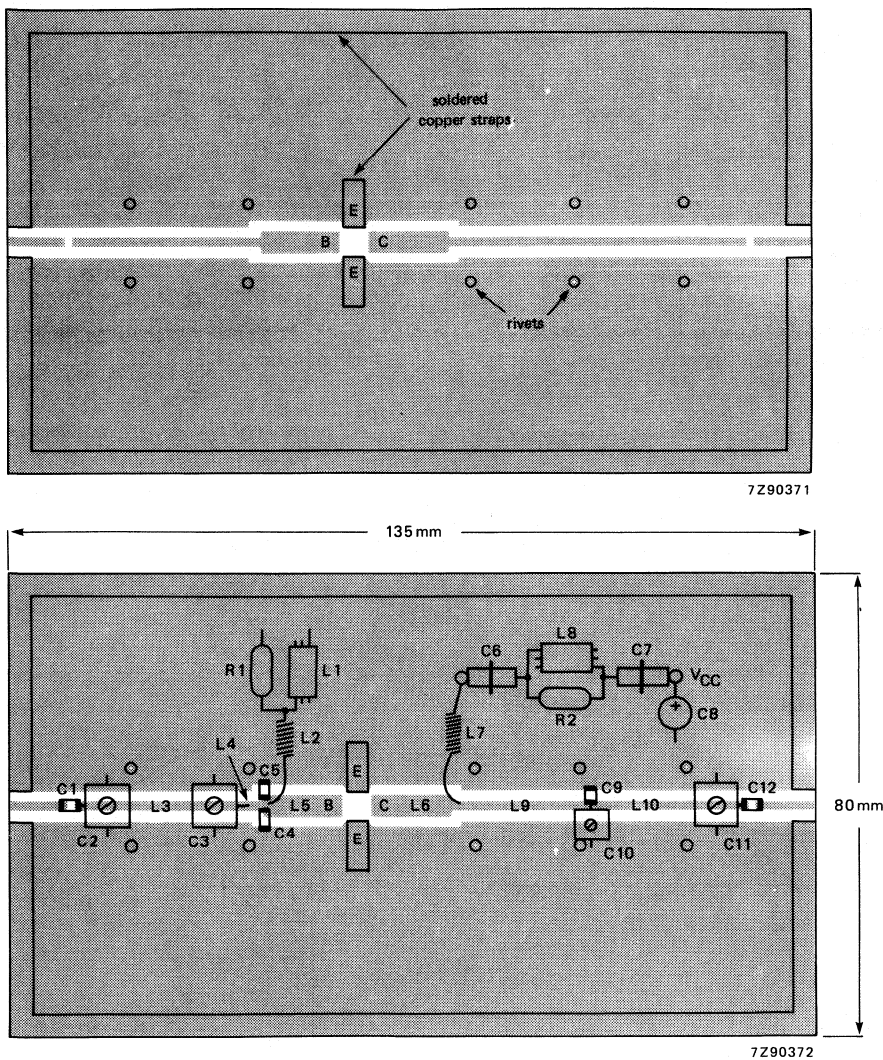


Fig. 8 Printed circuit board and component lay-out for 900 MHz class-B test circuit.

**Note**

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as ground plane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the ground plane.

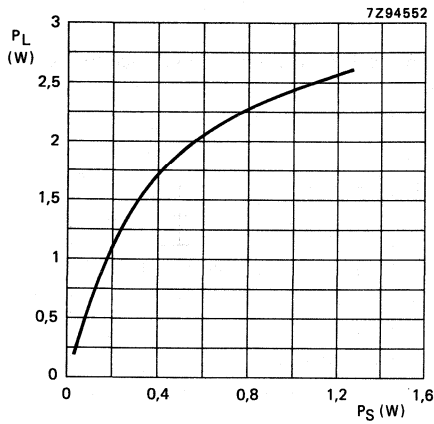


Fig. 9 Load power vs. source power.

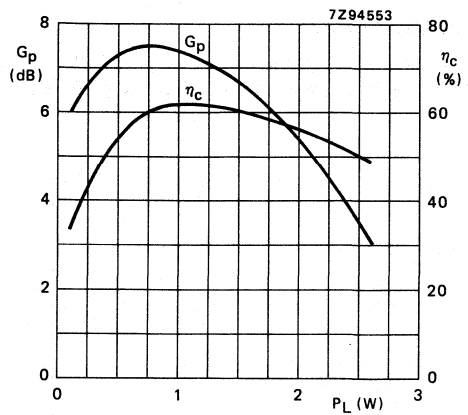


Fig. 10 Power gain and efficiency vs. load power.

Conditions for Figs 9 and 10:

$V_{CE} = 9,6 \text{ V}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

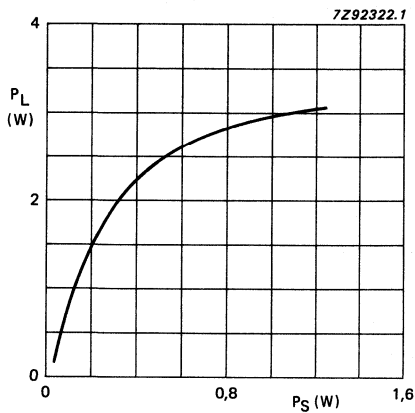


Fig. 11 Input impedance (series components).

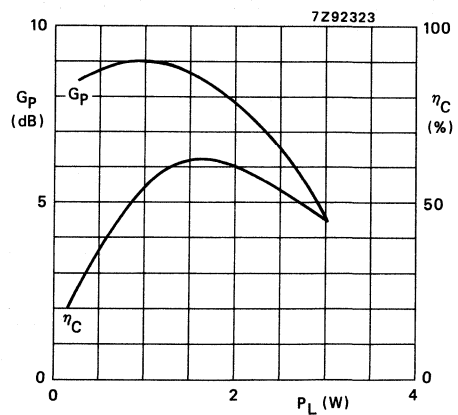


Fig. 12 Load impedance (series components).

Conditions for Figs 11 and 12:

$V_{CE} = 12,5 \text{ V}$ ;  $P_L = 2 \text{ W}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

**RUGGEDNESS**

The device is capable to withstand a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 15,5 V at  $T_h = 25\text{ }^\circ\text{C}$ .

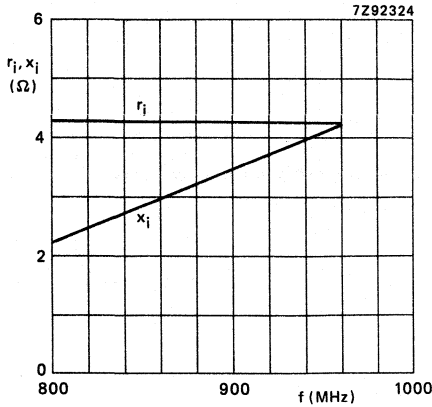


Fig. 13 Input impedance (series components).

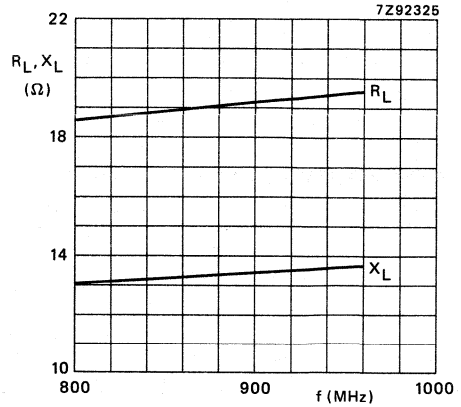


Fig. 14 Load impedance (series components).

Conditions for Figs 13 and 14:

$V_{CE} = 12,5\text{ V}$ ;  $P_L = 2\text{ W}$ ;  $f = 800\text{--}960\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.

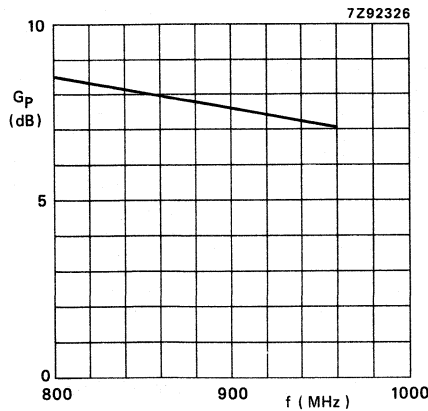


Fig. 15 Power gain vs. frequency.

$V_{CE} = 12,5\text{ V}$ ;  $P_L = 2\text{ W}$ ;  $f = 800\text{--}960\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.



## UHF POWER TRANSISTOR

NPN silicon planar epitaxial transistor designed for use in mobile radio transmitters in the 900 MHz band.

### Features:

- diffused emitter-ballasting resistors for an optimum temperature profile.
- gold metallization ensures excellent reliability.
- the device can be applied at rated load power, without an external heatsink, when it is mounted on a printed-circuit board (see Fig. 6).

The transistor has a 4-lead envelope with a ceramic cap (SOT-172D). All leads are isolated from the mounting base.

### QUICK REFERENCE DATA

RF performance in a common-emitter class-B circuit.

mode of operation	T <sub>oC</sub>	V <sub>CE</sub> V	f MHz	PL W	G <sub>p</sub> dB	η <sub>C</sub> %
narrow band; CW	T <sub>mb</sub> = 25	12.5	900	2	> 6.5	> 50
	T <sub>a</sub> = 25*	12.5	900	1.5	> 6.5	> 50
	T <sub>a</sub> = 25*	9.6	900	1.5	typ. 6.6	typ. 60

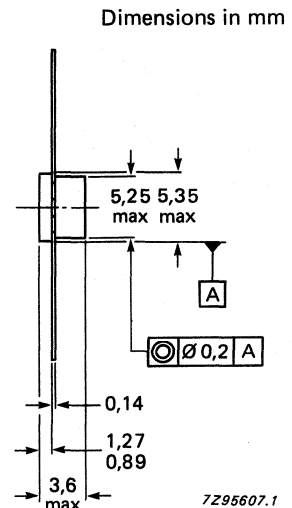
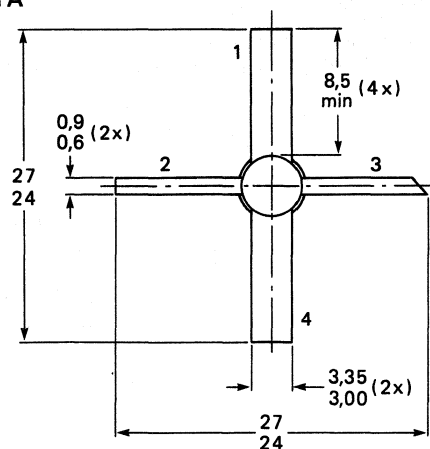
\* Device mounted on a printed-circuit board (see Fig. 6).

### MECHANICAL DATA

Fig. 1 SOT-172D.

#### Pinning:

- 1 Emitter
- 2 Base
- 3 Collector
- 4 Emitter



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current			
DC or average	$I_C; I_C(AV)$	max.	0.4 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	1.2 A
Total power dissipation			
$f > 1$ MHz; $T_{mb} \leq 90$ °C	$P_{tot}(RF)$	max.	6 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

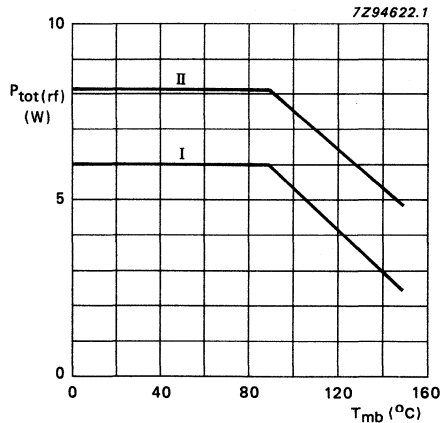


Fig. 2 Power/temperature curve.

- I Continuous RF operation ( $f > 1$  MHz)
- II Short-time RF operation during mismatch ( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 4.5 W

From junction to ambient\* ( $f > 1$  MHz)

$T_a = 25$  °C

$R_{th\ j-a} (RF)$  max. 55 K/W

From junction to mounting base

$T_{mb} = 25$  °C ( $f > 1$  MHz)

$R_{th\ j-mb} (RF)$  max. 15 K/W

\* Device mounted on a printed-circuit board (see Fig. 6).

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 5\text{ mA}$

Collector-emitter breakdown voltage  
open base;  $I_C = 10\text{ mA}$

Emitter-base breakdown voltage  
open collector;  $I_E = 0.5\text{ mA}$

Collector cut-off current  
 $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

D.C. current gain  
 $I_C = 0.3\text{ A}$ ;  $V_{CE} = 10\text{ V}$

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0$ ;  $V_{CB} = 12.5\text{ V}$

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 0$ ;  $V_{CE} = 12.5\text{ V}$

Collector-mounting base capacitance

$V_{(BR)CBO} > 36\text{ V}$

$V_{(BR)CEO} > 16\text{ V}$

$V_{(BR)EBO} > 3\text{ V}$

$I_{CES} < 2.5\text{ mA}$

$ESBR > 0.55\text{ mJ}$

$h_{FE} > 25$

$C_c$  typ.  $3.5\text{ pF}$

$C_{re}$  typ.  $2.0\text{ pF}$

$C_{c-mb}$  typ.  $0.5\text{ pF}$

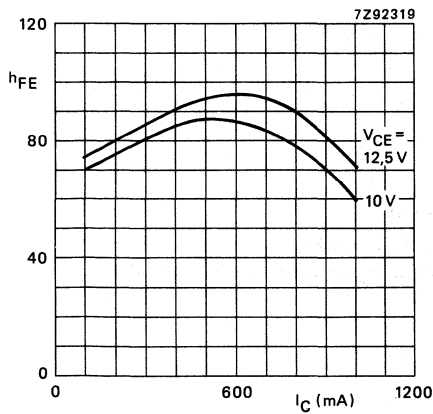


Fig. 3  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

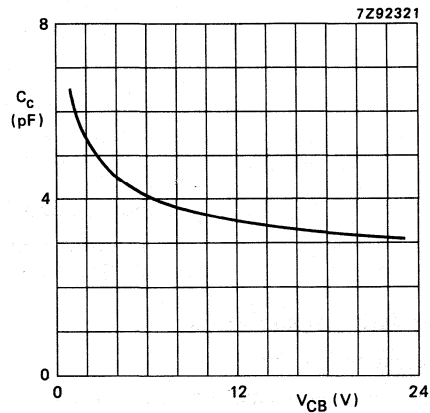
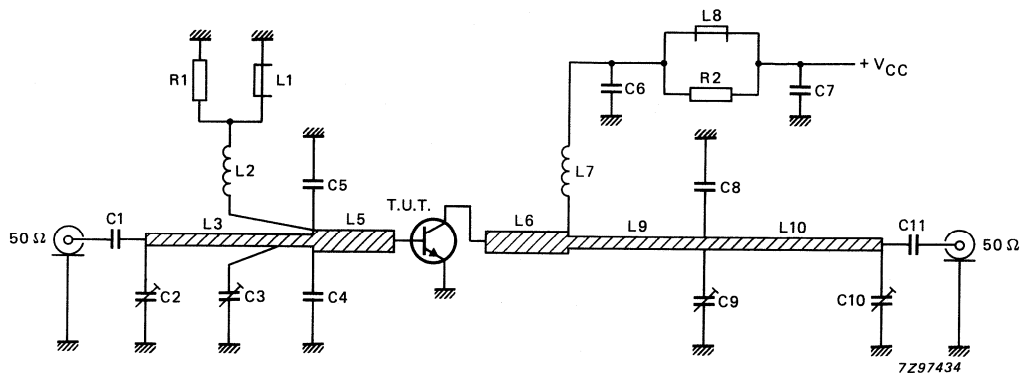


Fig. 4  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

## APPLICATION INFORMATION

RF performance in CW operation (common-emitter circuit; class-B):  $f = 900$  MHz

mode of operation	$V_{CE}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %	T $^{\circ}C$
narrow band; CW	12.5	2	$> 6.5$	$> 50$	$T_{mb} = 25$
	12.5	2	typ. 7.8	typ. 60	$T_{mb} = 25$
	12.5	1.5	$> 6.5$	$> 50$	$T_a = 25^{**}$
	9.6	1.5	typ. 6.6	typ. 60	$T_a = 25^{**}$

Fig. 5 Class-B test circuit at  $f = 900$  MHz.

## List of components:

- C1 = C11 = 33 pF multilayer ceramic chip capacitor
  - C2 = C3 = C10 = 1.4 to 5.5 pF film dielectric trimmer (cat. no. 2222 809 09001)
  - C4 = C5 = 5.6 pF multilayer ceramic chip capacitor\*
  - C6 = 10 pF multilayer ceramic chip capacitor
  - C7 = 330 pF multilayer ceramic chip capacitor
  - C8 = 3.9 pF multilayer ceramic chip capacitor\*
  - C9 = 1.2 to 3.5 pF film dielectric trimmer (cat. no. 2222 809 05001)
  - L1 = L8 = Ferroxcube wideband HF choke, grade 3B (cat. no. 4312 020 36642)
  - L2 = 60 nH; 4 turns closely wound enamelled Cu wire (0.4 mm); int. dia. 3 mm; leads 2 x 5 mm
  - L3 = 50  $\Omega$  stripline (25.4 mm x 2.4 mm)
  - L4 = 50  $\Omega$  stripline (4.4 mm x 2.4 mm)
  - L5 = L6 = 34  $\Omega$  stripline (14.0 mm x 4.0 mm)
  - L7 = 280 nH; 15 turns closely wound enamelled Cu wire (0.4 mm); int. dia. 3 mm; leads 2 x 5 mm
  - L9 = 50  $\Omega$  stripline (24.8 mm x 2.4 mm)
  - L10 = 50  $\Omega$  stripline (30.5 mm x 2.4 mm)
  - R1 = R2 = 10  $\Omega \pm 5\%$ ; 0.25 W metal film resistor
- L3, L4, L5, L6, L9 and L10 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch; thickness of copper-sheet 2 x 35  $\mu$ m.

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.

\*\* Device mounted on a printed-circuit board (see Fig. 6).



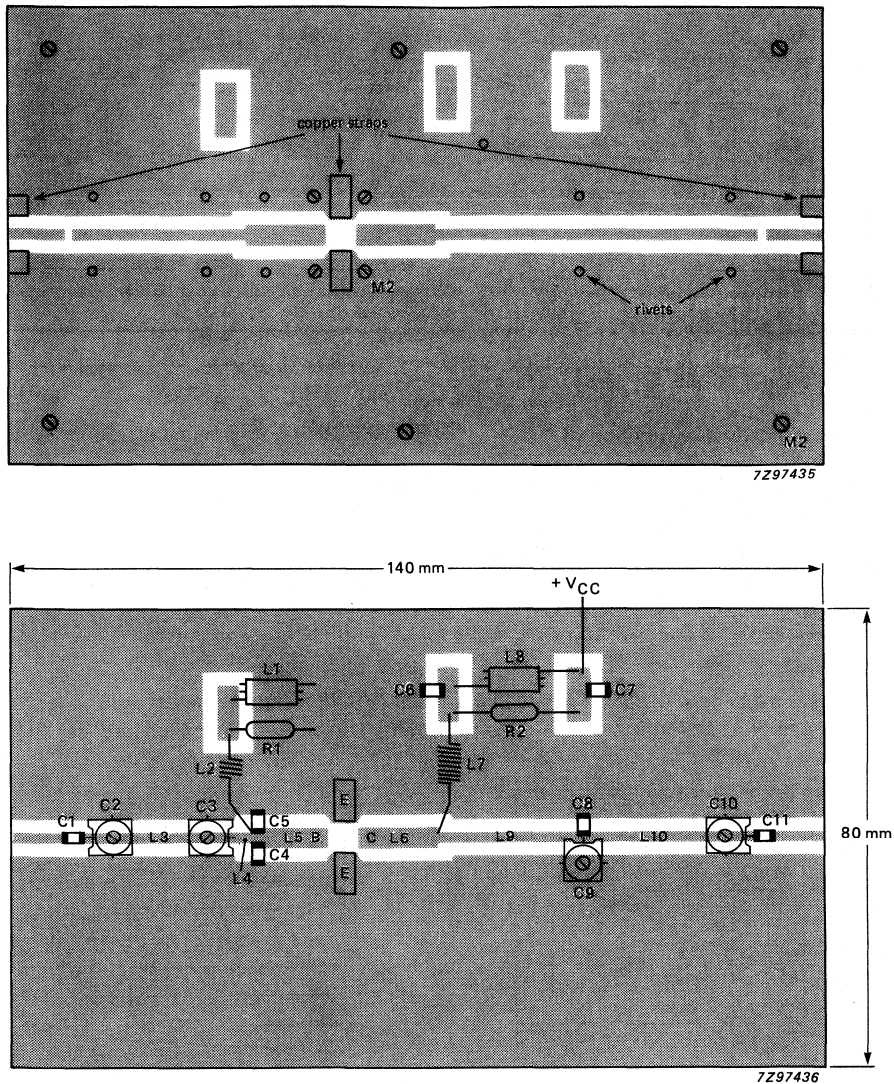


Fig. 6 Printed-circuit board and component lay-out for 900 MHz class-B test circuit.

#### Note

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as groundplane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the groundplane.

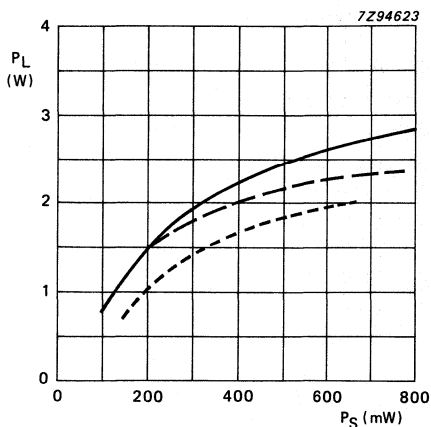


Fig. 7 Load power as a function of source power.

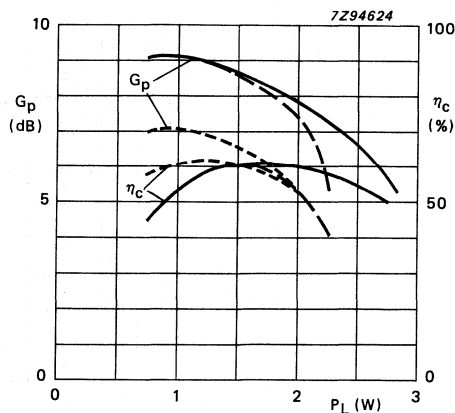


Fig. 8 Power gain and efficiency as a function of load power.

Conditions for Figs 7 and 8:

$f = 900$  MHz; class-B operation; typical values.

(—  $T_{mb} = 25^\circ\text{C}$ ;  $V_{CE} = 12.5$  V; - - -  $T_a = 25^\circ\text{C}$ ;  $V_{CE} = 12.5$  V; .....  $T_a = 25^\circ\text{C}$ ;  $V_{CE} = 9.6$  V)

**RUGGEDNESS**

The device is capable to withstand a full load mismatch (VSWR = 50; all phases) at  $P_L = 1.5$  W up to a supply voltage of 15.5 V at  $T_a = 25^\circ\text{C}$ . Device mounted on a printed-circuit board (see Fig. 6).

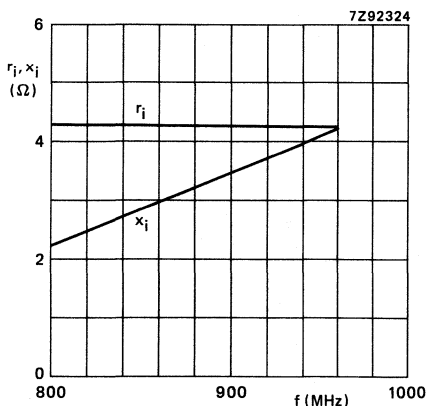


Fig. 9 Input impedance (series components).

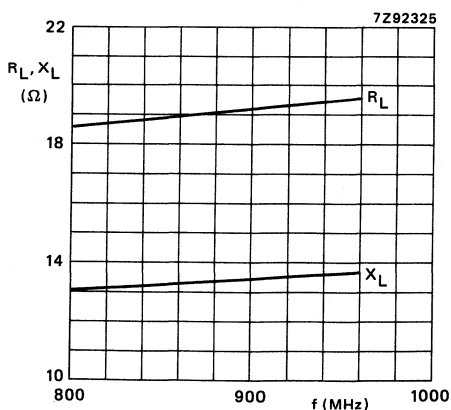


Fig. 10 Load impedance (series components).

Conditions for Figs 9 and 10:

$V_{CE} = 12.5$  V;  $P_L = 2$  W;  $f = 800 - 960$  MHz;  $T_{mb} = 25^\circ\text{C}$ ; class-B operation; typical values.

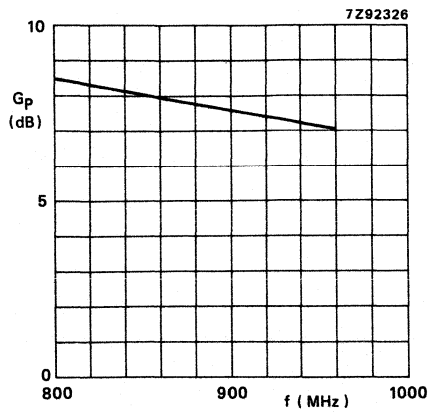


Fig. 11 Power gain as a function of frequency.

$V_{CE} = 12.5 \text{ V}$ ;  $P_L = 2 \text{ W}$ ;  $f = 800 - 960 \text{ MHz}$ ;  $T_{mb} = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in mobile radio transmitters in the 900 MHz communications band.

### Features:

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile
- internal input matching to achieve an optimum wideband capability and high power gain
- gold metallization ensures excellent reliability.

The transistor has a 6-lead flange envelope with a ceramic cap (SOT-171). All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance at  $T_h = 25^\circ\text{C}$  in a common-emitter class-B test circuit

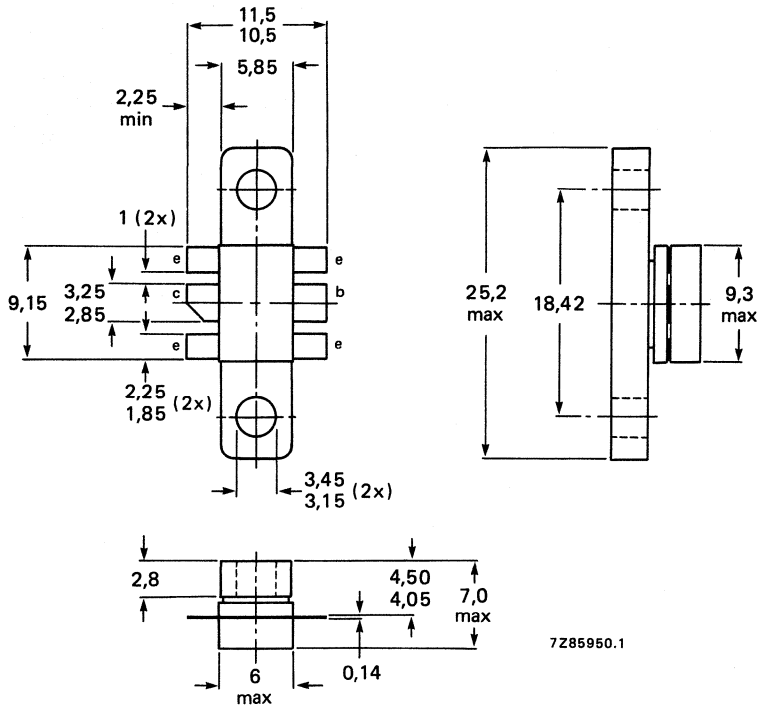
mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5 9,6	900 900	4 3	> 7,5 typ. 7,3	> 50 typ. 56

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-171.



Torque on screw: min. 0,6 Nm (6 kg.cm)

max. 0,75 Nm (7,5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A.

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current d.c. or average	$I_C$	max.	0,8 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	2,4 A
Total power dissipation at $T_{mb} = 94$ °C	$P_{tot(dc)}$	max.	9 W
at $T_{mb} = 94$ °C; $f > 1$ MHz	$P_{tot(rf)}$	max.	12 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

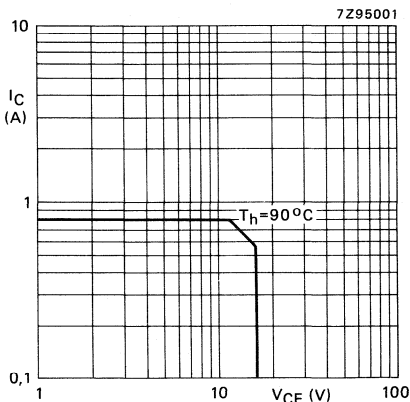


Fig. 2 D.C. SOAR.  
 $R_{th\ mb-h} = 0,4$  K/W.

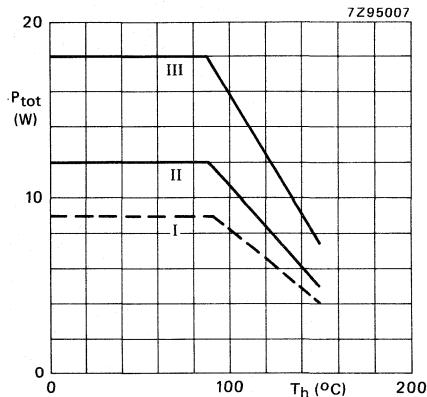


Fig. 3 Power/temperature derating curves.  
I Continuous operation  
II Continuous operation ( $f > 1$  MHz)  
III Short-time operation during mismatch;  
( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 6 W;  $T_{mb} = 128$  °C

From junction to mounting base  
(d.c. dissipation)  
(r.f. dissipation)

$R_{th\ j-mb(dc)}$	max.	12 K/W
$R_{th\ j-mb(rf)}$	max.	9 K/W
$R_{th\ mb-h}$	max.	0,4 K/W

From mounting base to heatsink

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage, open emitter;  $I_C = 10\text{ mA}$

Collector-emitter breakdown voltage, open base;  $I_C = 20\text{ mA}$

Emitter-base breakdown voltage, open collector;  $I_E = 1\text{ mA}$

Collector cut-off current,  $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

Second breakdown energy,  $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

D.C. current gain,  $I_C = 0,6\text{ A}$ ;  $V_{CE} = 10\text{ V}$

Transition frequency at  $f = 500\text{ MHz}^*$ ,  $-I_E = 0,6\text{ A}$ ;  $V_{CE} = 12,5\text{ V}$

Collector capacitance at  $f = 1\text{ MHz}$ ,  $I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

Feed-back capacitance at  $f = 1\text{ MHz}$ ,  $I_C = 0$ ;  $V_{CE} = 12,5\text{ V}$

Collector-flange capacitance

$V_{(BR)CBO}$	>	36 V
$V_{(BR)CEO}$	>	16 V
$V_{(BR)EBO}$	>	3 V
$I_{CES}$	<	5 mA
ESBR	>	1 mJ
$h_{FE}$	>	25
$f_T$	typ.	4 GHz
$C_c$	typ.	8 pF
$C_{re}$	typ.	5 pF
$C_{cf}$	typ.	2 pF

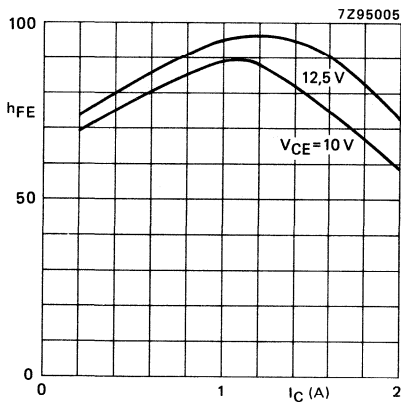


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

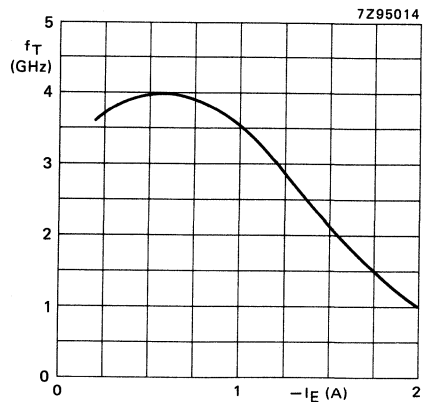


Fig. 5  $V_{CB} = 12,5\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

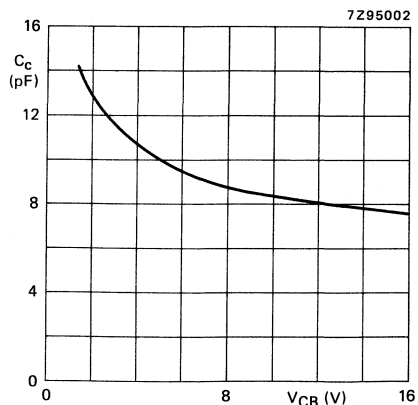


Fig. 6  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ; typical values.

\* Measured under pulse conditions:  $t_p = 50\text{ }\mu\text{s}$ ;  $\delta < 1\%$ .



## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class-B):  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

mode of operation	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta_C$ %
narrow band; c.w.	12,5	4	< 0,71 typ. 0,57	> 7,5 typ. 8,5	< 0,64 typ. 0,56	> 50 typ. 57
	9,6	3	typ. 0,56	typ. 7,3	typ. 0,56	typ. 56

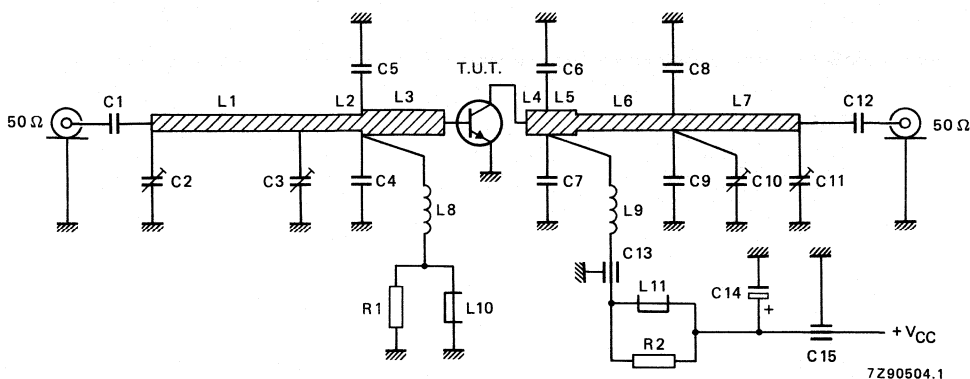


Fig. 7 Class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components:

C1 = C12 = 33 pF multilayer ceramic chip capacitor

C2 = C3 = C10 = C11 = 1,4 to 5,5 pF film dielectric trimmer  
(cat. no. 2222 809 09001)

C4 = C5 = 3,9 pF multilayer ceramic chip capacitor\*

C6 = C7 = C8 = C9 = 6,2 pF multilayer ceramic chip capacitor\*

C13 = 10 pF ceramic feed-through capacitor

C14 = 6,8  $\mu\text{F}$  (63 V) electrolytic capacitor

C15 = 330 pF ceramic feed-through capacitor

L1 = 50  $\Omega$  stripline (29,5 mm  $\times$  2,4 mm)

L2 = 50  $\Omega$  stripline (5,5 mm  $\times$  2,4 mm)

L3 = 42,7  $\Omega$  stripline (16,8 mm  $\times$  3,0 mm)

L4 = 42,7  $\Omega$  stripline (7,5 mm  $\times$  3,0 mm)

L5 = 42,7  $\Omega$  stripline (2,0 mm  $\times$  3,0 mm)

L6 = 50  $\Omega$  stripline (8,5 mm  $\times$  2,4 mm)

L7 = 50  $\Omega$  stripline (28,0 mm  $\times$  2,4 mm)

L8 = 60 nH; 4 turns closely wound enamelled Cu-wire (0,4 mm); int. dia. 3 mm; leads 2  $\times$  5 mm

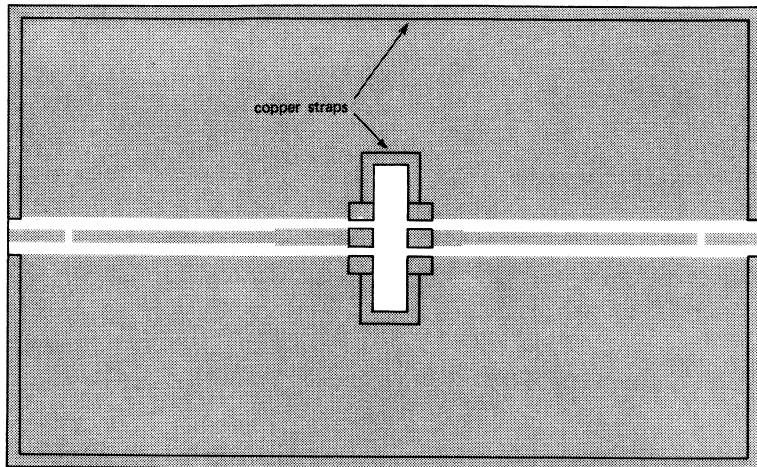
L9 = 45 nH; 4 turns enamelled Cu-wire (1,0 mm); length 6 mm; int. dia. 4 mm; leads 2  $\times$  5 mm

L10 = L11 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)

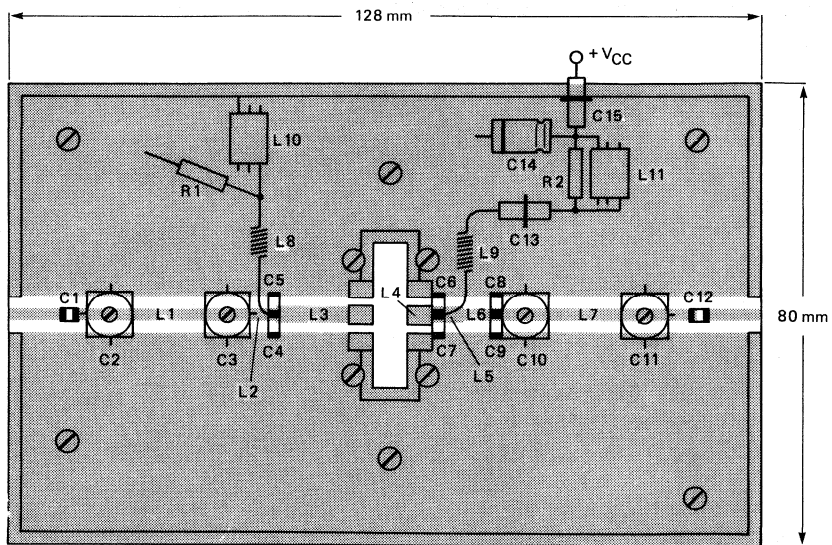
R1 = R2 = 10  $\Omega \pm 10\%$ ; 0,25 W, metal film resistor

L1 to L7 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch.

\* American Technical Ceramics capacitors type 100A or capacitor of same quality.



7Z90502



7Z90503.1

Fig. 8 Printed circuit board and component lay-out for 900 MHz class-B test circuit.

**Note**

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is un-etched copper serving as ground plane. Earth connections are made by fixing screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the ground plane.

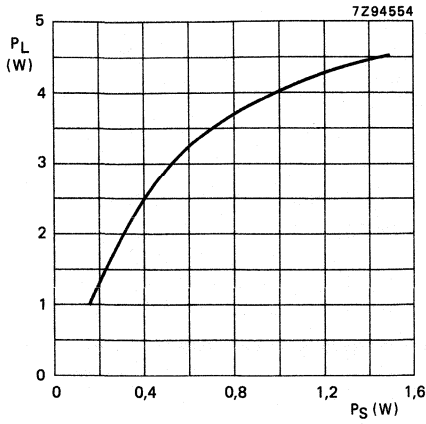


Fig. 9 Load power vs. source power.

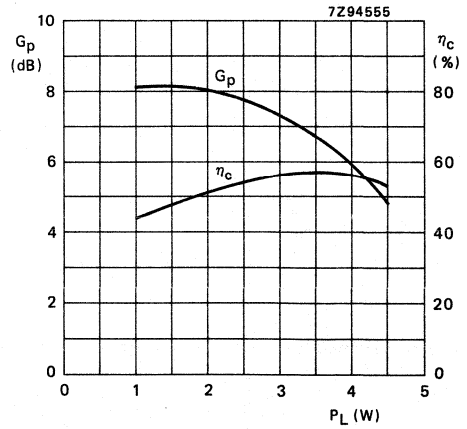


Fig. 10 Power gain and efficiency vs. load power.

Conditions for Figs 9 and 10:

$V_{CE} = 9,6 \text{ V}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

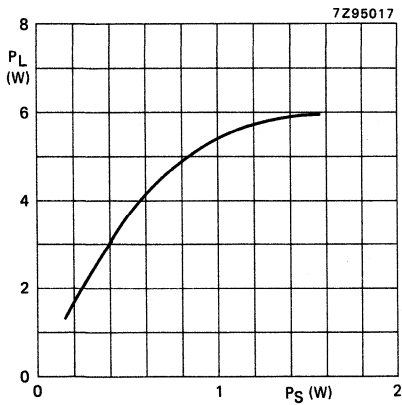


Fig. 11 Load power vs. source power.

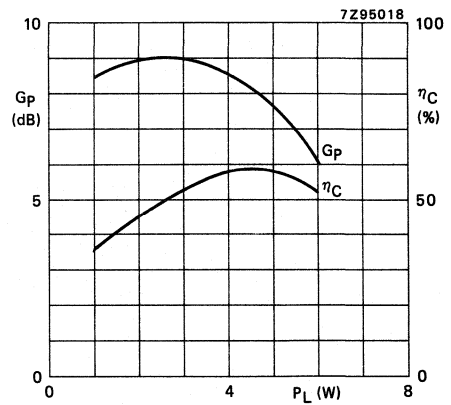


Fig. 12 Power gain and efficiency vs. load power.

Conditions for Figs 11 and 12:

$V_{CE} = 12,5 \text{ V}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 15,5 V and at  $T_h = 25\text{ }^\circ\text{C}$ .

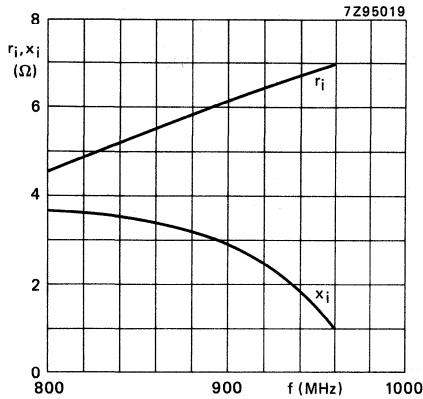


Fig. 13 Input impedance (series components).

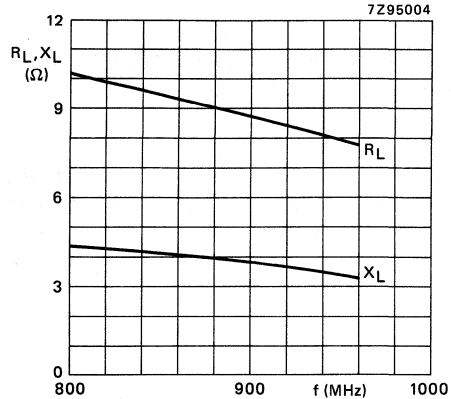


Fig. 14 Load impedance (series components).

Conditions for Figs 13 and 14:

$V_{CE} = 12,5\text{ V}$ ;  $P_L = 4\text{ W}$ ;  $f = 800\text{--}960\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.

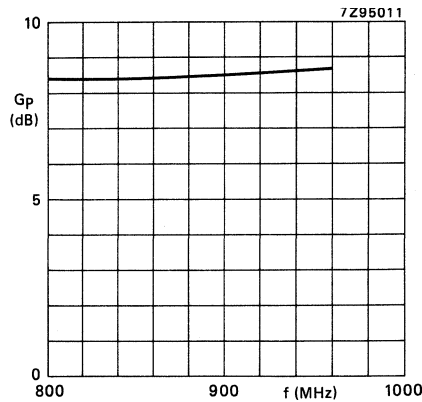


Fig. 15 Power gain vs. frequency.

$V_{CE} = 12,5\text{ V}$ ;  $P_L = 4\text{ W}$ ;  $f = 800\text{--}960\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.

## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in mobile radio transmitters in the 900 MHz communications band.

### Features:

- multi-base structure and emitter-ballasting resistors for an optimum temperature profile
- internal input matching to achieve an optimum wideband capability and high power gain
- gold metallization ensures excellent reliability.

The transistor has a 6-lead flange envelope with a ceramic cap (SOT-171). All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-emitter class-B test circuit

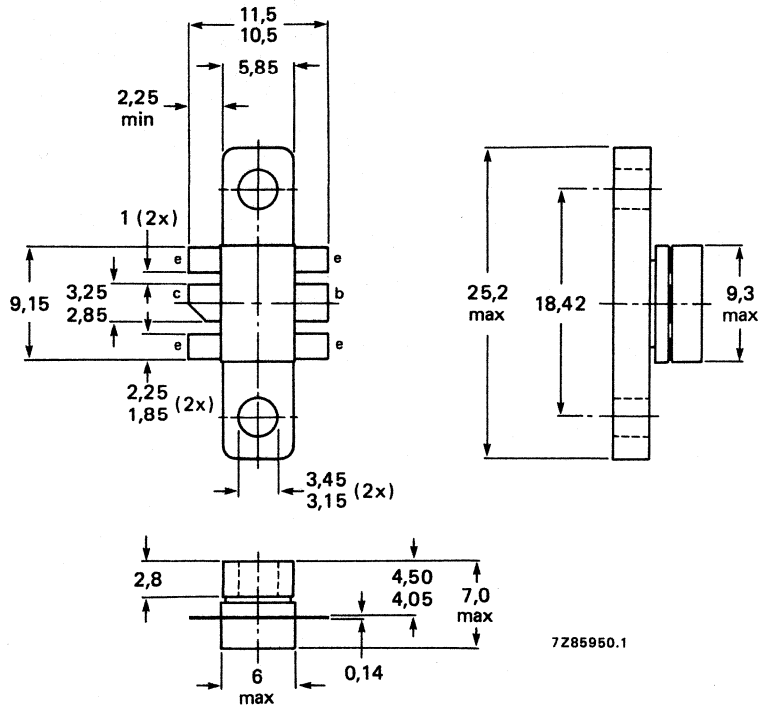
mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	900	8	> 6,5	> 50
	9,6	900	6	typ. 6,0	typ. 59

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

## MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-171.



Torque on screw: min. 0,6 Nm (6 kg.cm)  
 max. 0,75 Nm (7,5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3 V
Collector current d.c. or average (peak value); $f > 1$ MHz	$I_C; I_{CAV}$	max.	1,6 A
	$I_{CM}$	max.	4,8 A
Total power dissipation at $T_{mb} = 67^\circ\text{C}$	$P_{tot(dc)}$	max.	18 W
at $T_{mb} = 67^\circ\text{C}; f > 1$ MHz	$P_{tot(rf)}$	max.	24 W
Storage temperature	$T_{stg}$		-65 to + 150 $^\circ\text{C}$
Operating junction temperature	$T_j$	max.	200 $^\circ\text{C}$

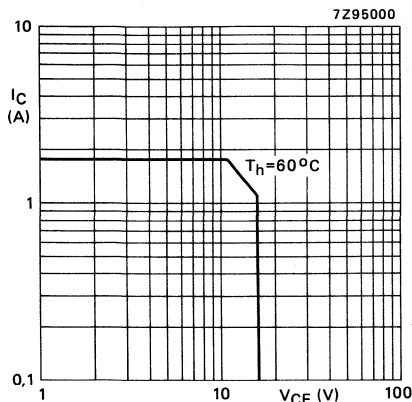


Fig. 2 D.C.-SOAR.

$R_{th\ mb-h} = 0,4\ \text{K/W}$

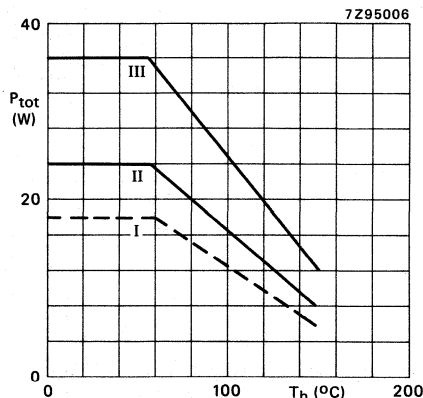


Fig. 3 Power/temperature derating curves.

- I Continuous operation
- II Continuous operation ( $f > 1$  MHz)
- III Short-time operation during mismatch; ( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 12 W;  $T_{mb} = 112^\circ\text{C}$

From junction to mounting base

(d.c. dissipation)

(r.f. dissipation)

$R_{thj-mb(dc)}$  max. 7,0 K/W

$R_{thj-mb(rf)}$  max. 5,2 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  max. 0,4 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 20\text{ mA}$

$$V_{(BR)CBO} > 36\text{ V}$$

Collector-emitter breakdown voltage  
open base;  $I_C = 40\text{ mA}$

$$V_{(BR)CEO} > 16\text{ V}$$

Emitter-base breakdown voltage  
open collector;  $I_E = 2\text{ mA}$

$$V_{(BR)EBO} > 3\text{ V}$$

Collector cut-off current  
 $V_{BE} = 0; V_{CE} = 16\text{ V}$

$$I_{CES} < 10\text{ mA}$$

Second breakdown energy  
 $L = 25\text{ mH}; f = 50\text{ Hz}; R_{BE} = 10\text{ }\Omega$

$$E_{SBR} > 2\text{ mJ}$$

D.C. current gain

$$I_C = 1,2\text{ A}; V_{CE} = 10\text{ V}$$

$$h_{FE} > 25$$

Transition frequency at  $f = 500\text{ MHz}^*$

$$-I_E = 1,2\text{ A}; V_{CB} = 12,5\text{ V}$$

$$f_T \text{ typ. } 4\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = i_e = 0; V_{CB} = 12,5\text{ V}$$

$$C_C \text{ typ. } 15\text{ pF}$$

Feed-back capacitance at  $f = 1\text{ MHz}$

$$I_C = 0; V_{CE} = 12,5\text{ V}$$

$$C_{re} \text{ typ. } 9\text{ pF}$$

Collector-flange capacitance

$$C_{cf} \text{ typ. } 2\text{ pF}$$

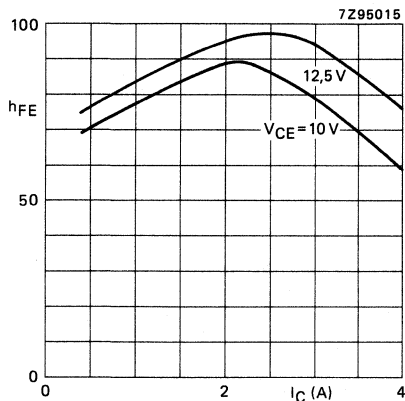


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ ; typical values.

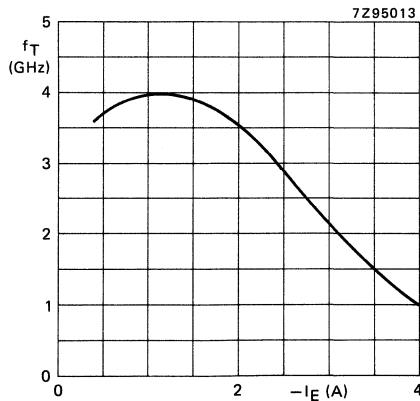


Fig. 5  $V_{CB} = 12,5\text{ V}; f = 500\text{ MHz}; T_j = 25\text{ }^\circ\text{C}$ ; typical values.

\* Measured under pulse conditions:  $t_p = 50\text{ }\mu\text{s}; \delta < 1\%$ .



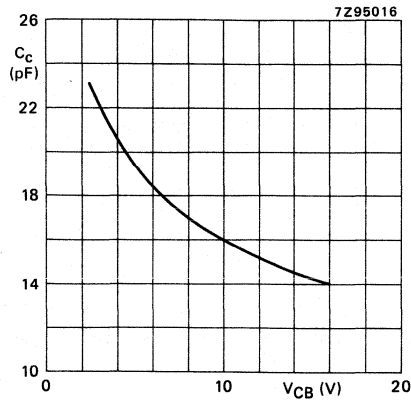


Fig. 6  $I_E = i_e = 0$ ;  $f = 1$  MHz; typical values.

**APPLICATION INFORMATION**

R.F. performance in c.w. operation (common-emitter circuit; class-B):  $f = 900$  MHz;  $T_h = 25$  °C.

mode of operation	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta_C$ %
narrow band; c.w.	12,5	8	< 1,8 typ. 1,5	> 6,5 typ. 7,3	< 1,28 typ. 1,1	> 50 typ. 58
	9,6	6	typ. 1,5	typ. 6,0	typ. 1,05	typ. 59

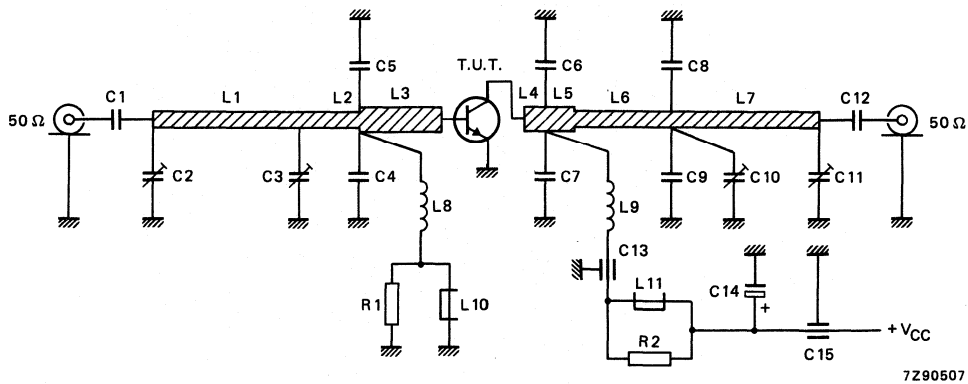
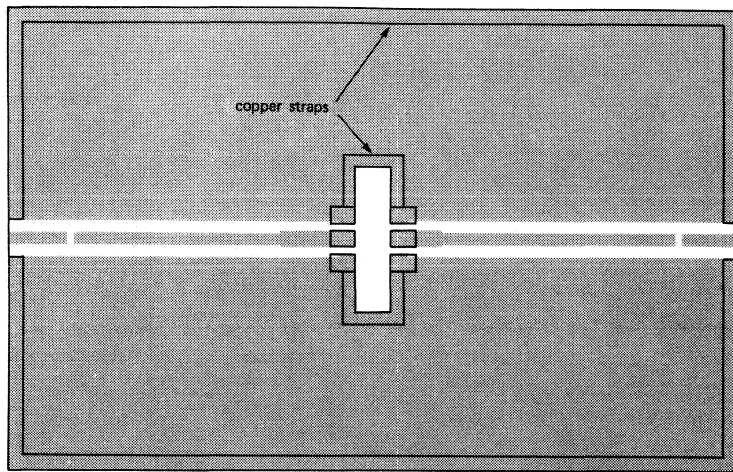


Fig. 7 Class-B test circuit at  $f = 900$  MHz.

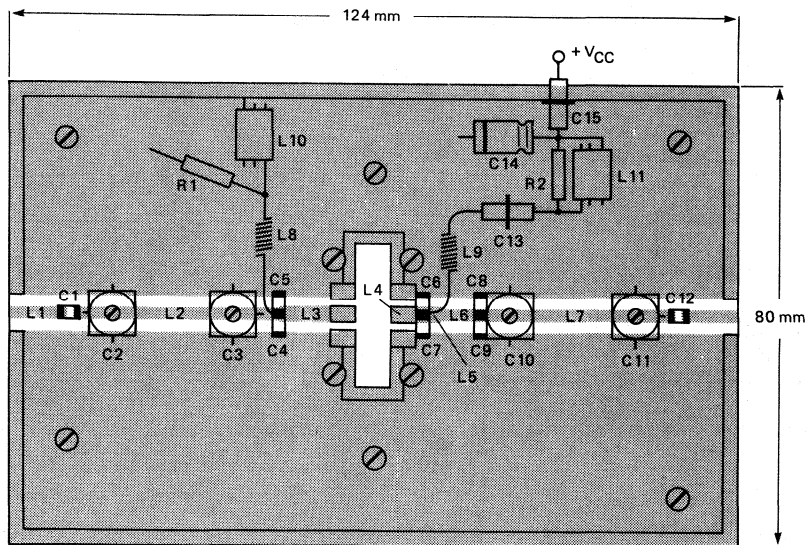
List of components:

- C1 = C12 = 33 pF multilayer ceramic chip capacitor  
 C2 = C3 = C10 = C11 = 1,4 to 5,5 pF film dielectric trimmer  
 (cat. no. 2222 809 09001)  
 C4 = C5 = 4,7 pF multilayer ceramic chip capacitor\*  
 C6 = C7 = 5,6 pF multilayer ceramic chip capacitor\*  
 C8 = C9 = 3,3 pF multilayer ceramic chip capacitor\*  
 C13 = 10 pF ceramic feed-through capacitor  
 C14 = 6,8  $\mu$ F (63 V) electrolytic capacitor  
 C15 = 330 pF ceramic feed-through capacitor  
 L1 = L7 = 50  $\Omega$  stripline (29,0 x 2,4 mm)  
 L2 = 50  $\Omega$  stripline (6,0 mm x 2,4 mm)  
 L3 = 42,7  $\Omega$  stripline (13,1 mm x 3,0 mm)  
 L4 = 42,7  $\Omega$  stripline (4,4 mm x 3,0 mm)  
 L5 = 42,7  $\Omega$  stripline (4,6 mm x 3,0 mm)  
 L6 = 50  $\Omega$  stripline (11,0 x 2,4 mm)  
 L8 = 60 nH; 4 turns closely wound enamelled Cu-wire (0,4 mm); int. dia. 3 mm; leads 2 x 5 mm  
 L9 = 45 nH; 4 turns enamelled Cu-wire (1,0 mm); length 6 mm; int. dia 4 mm; leads 2 x 5 mm  
 L10 = L11 = Ferroxcube wideband h.f. choke, grade 3B (cat. no. 4312 020 36642)  
 R1 = R2 = 10  $\Omega$   $\pm$  10%; 0,25 W, metal film resistor  
 L1 to L7 are striplines on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch.

\* American Technical Ceramics capacitor type 100A or capacitor of same quality.



7Z90505



7Z90506

Fig. 8 Printed circuit board and component lay-out for 900 MHz class-B test circuit.

#### Note

The circuit and the components are on one side of the P.T.F.E. fibre-glass board; the other side is un-etched copper serving as ground plane. Earth connections are made by fixing screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the ground plane.

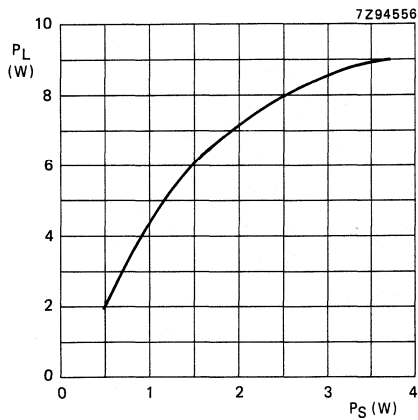


Fig. 9 Load power vs. source power.

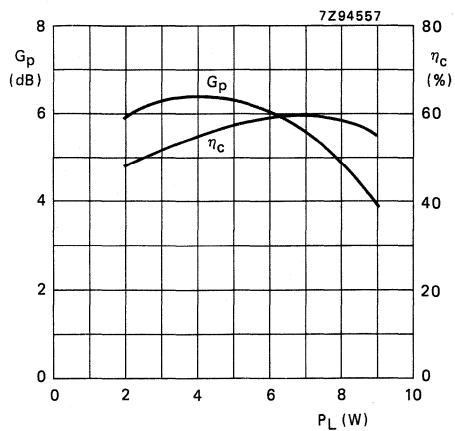


Fig. 10 Power gain and efficiency vs. load power.

Conditions for Figs 9 and 10:

$V_{CE} = 9,6 \text{ V}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

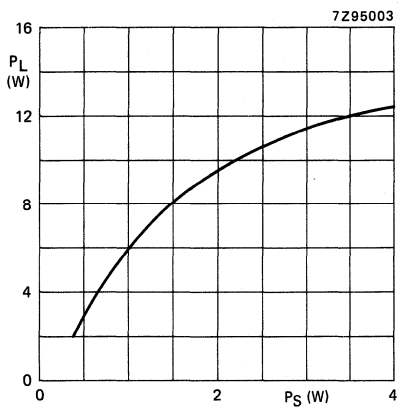


Fig. 11 Load power vs. source power.

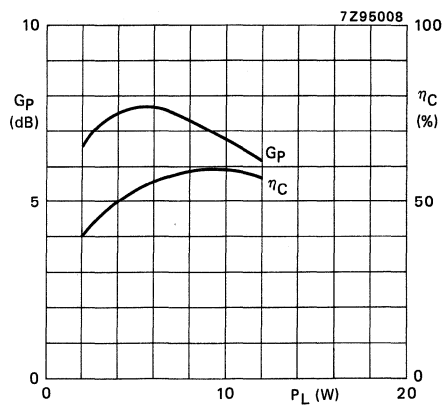


Fig. 12 Power gain and efficiency vs. load power.

Conditions for Figs 11 and 12:

$V_{CE} = 12,5 \text{ V}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation; typical values.

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 15,5 V and at  $T_h = 25\text{ }^\circ\text{C}$ .

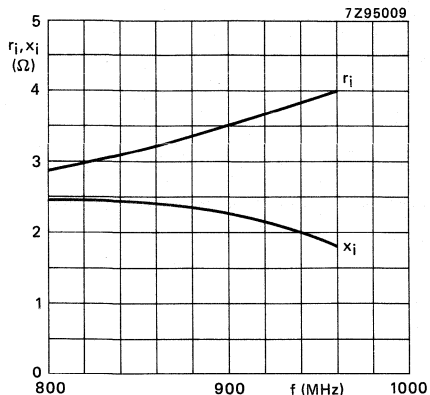


Fig. 13 Input impedance (series components).

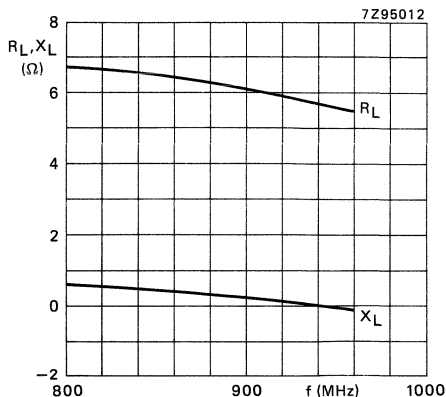


Fig. 14 Load impedance (series components).

Conditions for Figs 13 and 14:

$V_{CE} = 12,5\text{ V}$ ;  $P_L = 8\text{ W}$ ;  $f = 800\text{--}960\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.

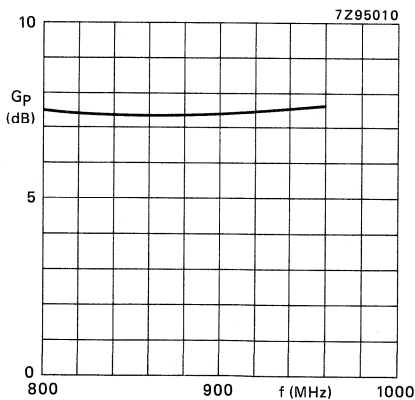


Fig. 15 Power gain vs. frequency.

$V_{CE} = 12,5\text{ V}$ ;  $P_L = 8\text{ W}$ ;  $f = 800\text{--}960\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.



## UHF POWER TRANSISTOR

NPN silicon planar epitaxial transistor primarily intended for common base, class-B operation in mobile radio transmitters for the 900 MHz communication band.

### Features

- Emitter-ballasting resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability
- Internal input matching to achieve an optimum wideband capability and stable operation

The transistor has a 6-lead flange envelope with a ceramic cap (SOT171). All leads are isolated from the flange.

### QUICK REFERENCE DATA

RF performance up to  $T_h = 25\text{ }^\circ\text{C}$  in a common-base class-B circuit

mode of operation	$V_{CB}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; CW	12.5	900	15	> 6	> 50

### MECHANICAL DATA

SOT171 (see Fig.1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

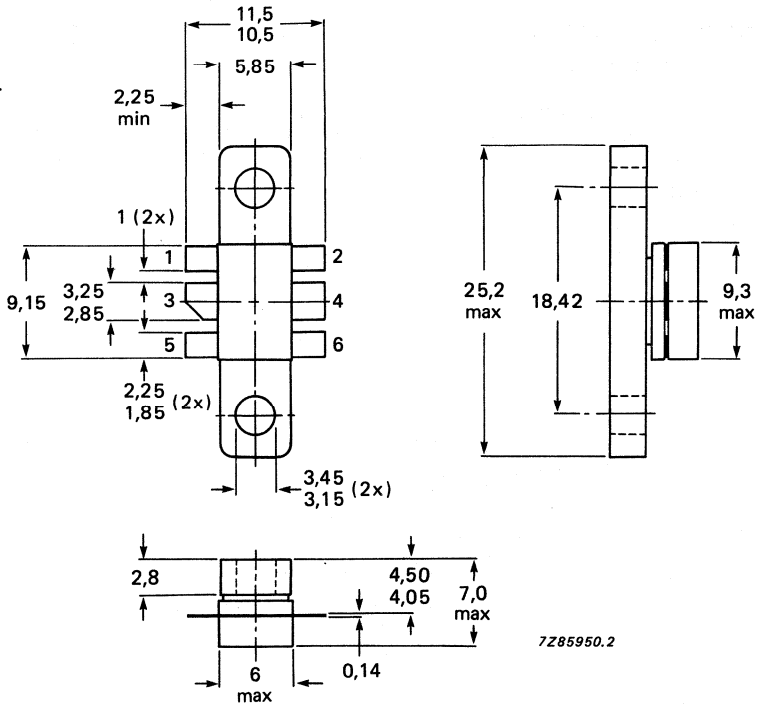
**MECHANICAL DATA**

Dimensions in mm

Fig.1 SOT171.

**Pinning:**

- 1 Base
- 2 Base
- 3 Collector
- 4 Emitter
- 5 Base
- 6 Base



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Torque on screw: min. 0.6 Nm (6 kg.cm)  
 max. 0.75 Nm (7.5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

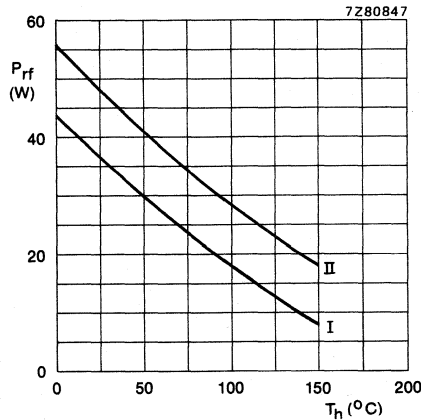
Heatsink compound must be applied sparingly and evenly distributed.



**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CB0}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CE0}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EB0}$	max.	3.5 V
Collector current			
DC or average	$I_C$	max.	3 A
peak value; $f > 1$ MHz	$I_{CM}$	max.	9 A
Total power dissipation			
at $T_{mb} = 25^\circ\text{C}$ ; $f > 1$ MHz	$P_{tot}$	max.	45 W
Storage temperature range	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C



- I Continuous operation ( $f > 1$  MHz)
- II Short-time operation during mismatch; ( $f > 1$  MHz)

Fig.2 Power/temperature derating curves.

**THERMAL RESISTANCE**

From junction to mounting base (RF operation)	$R_{th\ j-mb}$	max.	4 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0.4 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 25\text{ mA}$

Collector-emitter breakdown voltage  
open base;  $I_C = 50\text{ mA}$

Emitter-base breakdown voltage  
open collector;  $I_E = 5\text{ mA}$

Collector cut-off current  
 $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

DC current gain  
 $V_{CE} = 10\text{ V}$ ;  $I_C = 2\text{ A}$

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0$ ;  $V_{CB} = 12.5\text{ V}$

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_E = 0$ ;  $V_{CB} = 12.5\text{ V}$

Collector-flange capacitance

$V_{(BR)CBO}$  min. 36 V

$V_{(BR)CEO}$  min. 16 V

$V_{(BR)EBO}$  min. 3.5 V

$I_{CES}$  max. 10 mA

ESBR min. 4.5 mJ

$h_{FE}$  min. 15  
typ. 65

$C_c$  typ. 33 pF

$C_{rb}$  typ. 9 pF

$C_{cf}$  typ. 2 pF

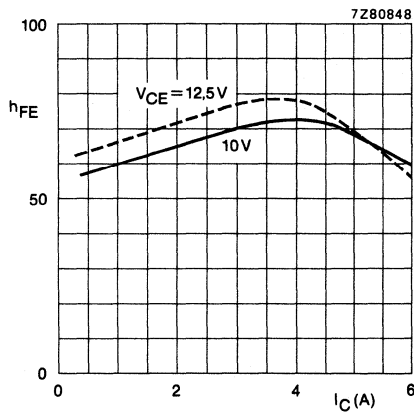


Fig.3 DC current gain as a function of collector current;  $T_j = 25\text{ }^\circ\text{C}$ . Typical values.

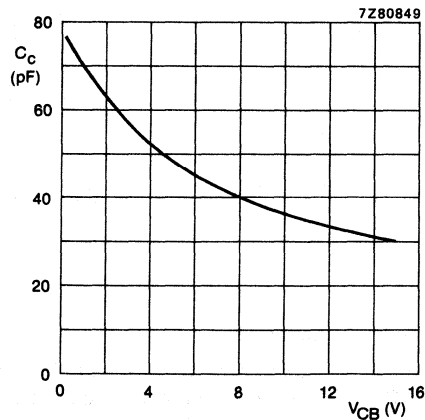


Fig.4 Output capacitance as a function of  $V_{CB}$ ;  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ . Typical values.

## APPLICATION INFORMATION

RF performance in CW operation (common-base circuit; class-B)  
 $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$

mode of operation	$V_{CB}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; CW	12.5	15	> 6.0 typ. 7.0	> 50 typ. 61

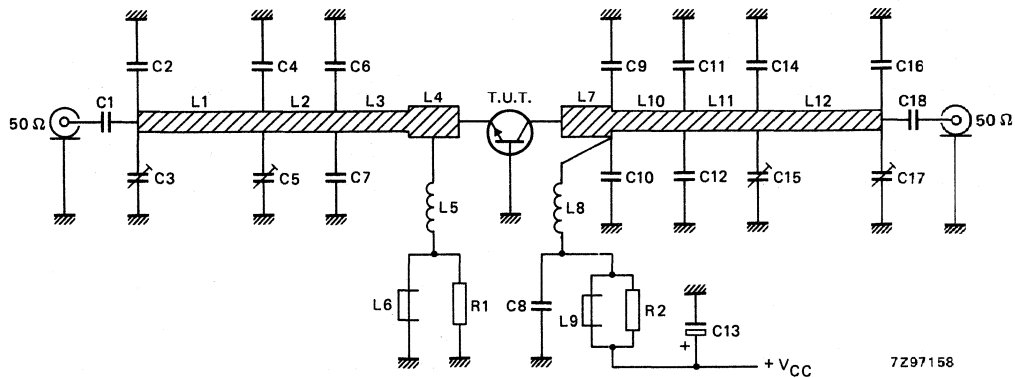


Fig.5 Class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components:

- $C_1 = C_{18} = 330 \text{ pF}$  multilayer ceramic chip capacitor \*
- $C_2 = C_4 = C_{16} = 5.6 \text{ pF}$  multilayer ceramic chip capacitor \*
- $C_3 = C_5 = C_{15} = C_{17} = 1.4 \text{ to } 5.5 \text{ pF}$  film dielectric trimmer  
(cat. no. 2222 809 09001)
- $C_6 = C_7 = 4.3 \text{ pF}$  multilayer ceramic chip capacitor \*
- $C_8 = 330 \text{ pF}$  multilayer ceramic chip capacitor
- $C_9 = C_{10} = 5.6 \text{ pF}$  multilayer ceramic chip capacitors \*\*
- $C_{11} = C_{12} = 6.2 \text{ pF}$  multilayer ceramic chip capacitor \*

C<sub>13</sub> = 6.8  $\mu$ F (63 V) electrolytic capacitor

C<sub>14</sub> = 2.2 pF multilayer ceramic chip capacitor \*

L<sub>1</sub> = L<sub>12</sub> = 50  $\Omega$  stripline (24 mm x 2.4 mm)

L<sub>2</sub> = L<sub>11</sub> = 50  $\Omega$  stripline (10 mm x 2.4 mm)

L<sub>3</sub> = 50  $\Omega$  stripline (8 mm x 2.4 mm)

L<sub>4</sub> = L<sub>7</sub> = 41  $\Omega$  (3 mm x 3.2 mm)

L<sub>5</sub> = L<sub>8</sub> = 4 turns Cu-wire (1.0 mm); int. dia. 4 mm; length 5 mm;  
leads 2 x 7 mm

L<sub>6</sub> = L<sub>9</sub> = Ferroxcube wideband HF choke; grade 3B (cat. no 4312 020 36642)

L<sub>10</sub> = 50  $\Omega$  stripline (7 mm x 2.4 mm)

R<sub>1</sub> = R<sub>2</sub> = 10  $\Omega$   $\pm$  10 %; 0.25 W, metal film resistor

The striplines are on a double Cu-clad printed circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch.

\* American Technical Ceramics capacitor type 100B or capacitor of the same quality.

\*\* Idem type 100A.

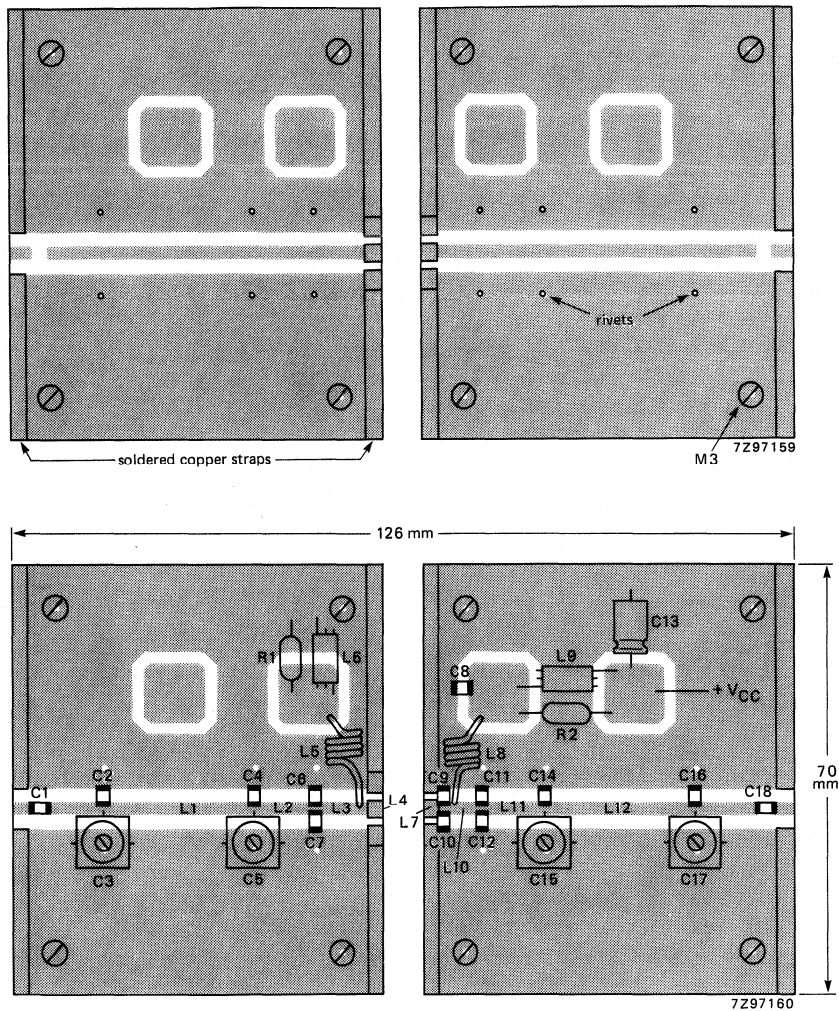


Fig.6 Printed-circuit board and component lay-out for 900 MHz class-B test circuit.

The circuit and components are on one side of the PTFE fibre-glass board; the other side is unetched copper serving as a ground plane.

Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the bases to provide a direct contact between the copper of the component side and the ground plane.

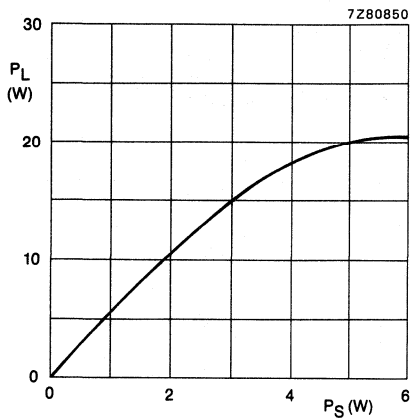


Fig.7 Load power as a function of source power.

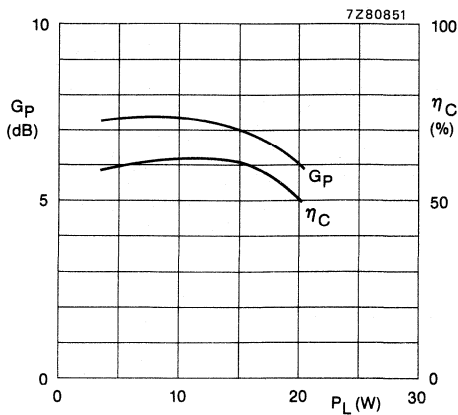


Fig.8 Power gain and efficiency as functions of load power.

**Conditions for Figs 7 and 8:**

$V_{CB} = 12.5$  V;  $f = 900$  MHz;  $T_h = 25$  °C; class-B operation;  
 $R_{th\ mb-h} = 0.4$  K/W; typical values.

**RUGGEDNESS**

The BLV94 is capable of withstanding a load mismatch (VSWR = 50 through all phases) at rated load power up to a supply voltage of 15.5 V at  $T_h = 25$  °C and  $R_{th\ mb-h} = 0.4$  K/W.

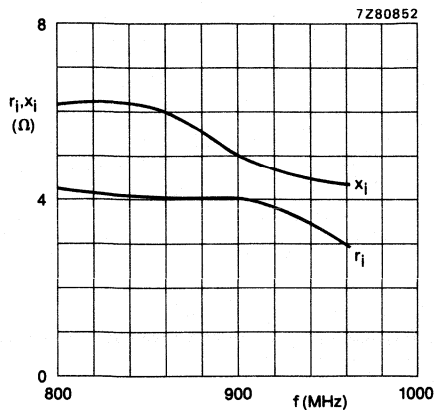


Fig.9 Input impedance (series components) as a function of frequency.

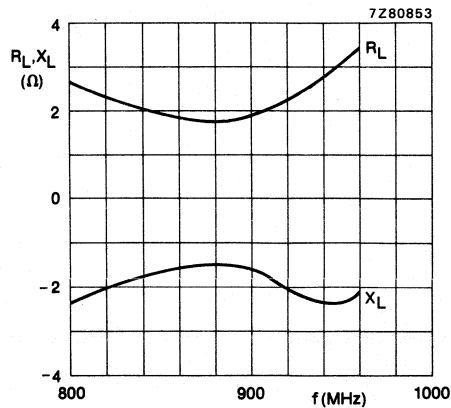


Fig.10 Load impedance (series components) as a function of frequency.

**Conditions for Figs 9, 10 and 11:**

Typical values;  $V_{CE} = 12.5$  V;  $P_L = 15$  W;  $f = 800$  to  $960$  MHz;

$R_{th\ mb-h} = 0.4$  K/W;  $T_h = 25$  °C.

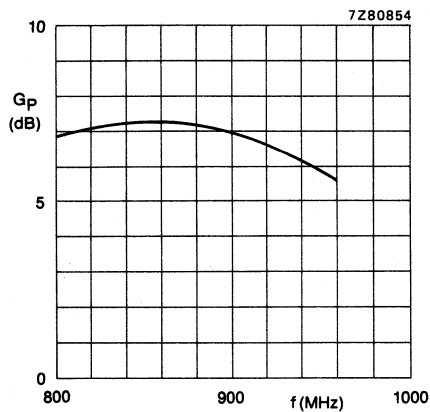


Fig.11 Power gain as a function of frequency.





## U.H.F. POWER TRANSISTOR

N,P,N silicon planar epitaxial transistor primarily intended for use in mobile radio transmitters for the 900 MHz communication band.

### Features

- multi base structure and emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability
- internal input matching to achieve an optimum wideband capability and high power gain

The transistor has a 6-lead flange envelope with a ceramic cap (SOT-171). The device has a common-base pinning and all leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in a common-base class-B circuit

mode of operation	$V_{CB}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	900	22	> 5,5	> 50

### MECHANICAL DATA

Dimensions in mm

SOT-171. (see Fig. 1)

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

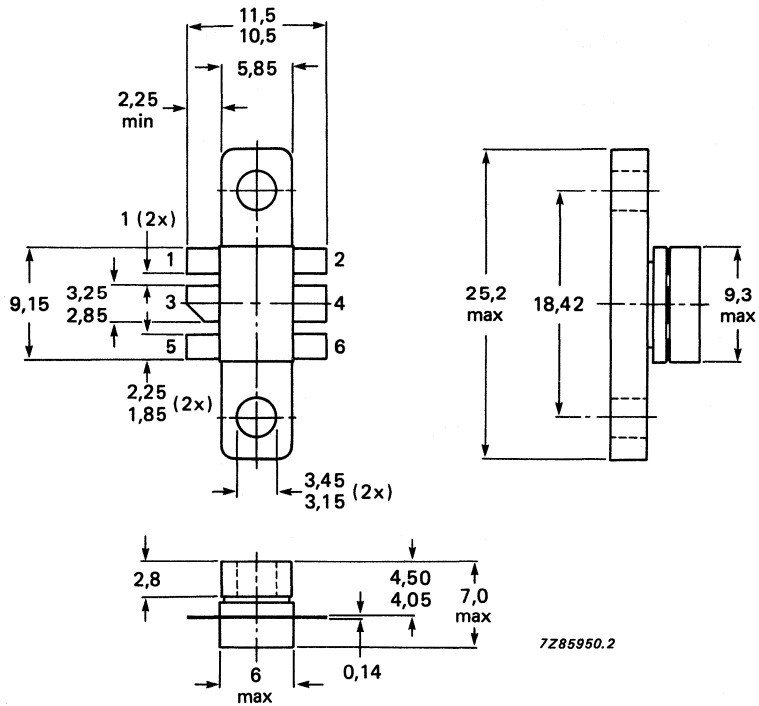
MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-171.

Pinning:

- 1 Base
- 2 Base
- 3 Collector
- 4 Emitter
- 5 Base
- 6 Base



Torque on screw: min. 0,6 Nm (6 kg.cm)

max. 0,75 Nm (7,5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CB0}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CE0}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EB0}$	max.	3,5 V
Collector current			
d.c. or average	$I_C$	max.	5 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	15 A
Total power dissipation			
at $T_{mb} = 25$ °C; $f > 1$ MHz	$P_{tot}$	max.	70 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

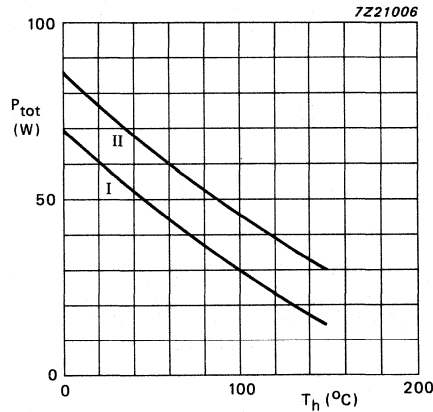


Fig. 2 Power/temperature derating curves.

- I Continuous operation ( $f > 1$  MHz).
- II Short-time operation during mismatch; ( $f > 1$  MHz).

**THERMAL RESISTANCE**

Dissipation = 60 W;  $T_{mb} = 25$  °C

From junction to mounting base (r.f. operation)	$R_{th\ j-mb}$ (r.f.)	max.	2,5 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0,4 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 50\text{ mA}$

$V_{(BR)CBO}$  min. 36 V

Collector-emitter breakdown voltage  
open base;  $I_C = 100\text{ mA}$

$V_{(BR)CEO}$  min. 16 V

Emitter-base breakdown voltage  
open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO}$  min. 3,5 V

Collector cut-off current  
 $V_{BE} = 0$ ;  $V_{CE} = 16\text{ V}$

$I_{CES}$  max. 15 mA

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$E_{SBR}$  min. 6,5 mJ

D.C. current gain  
 $I_C = 3,5\text{ A}$ ;  $V_{CE} = 10\text{ V}$

$h_{FE}$  min. 15  
typ. 60

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0$ ;  $V_{CB} = 12,5\text{ V}$

$C_C$  typ. 62 pF

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_E = 0$ ;  $V_{CB} = 12,5\text{ V}$

$C_{fb}$  typ. 20 pF

Collector-flange capacitance

$C_{cf}$  typ. 3 pF

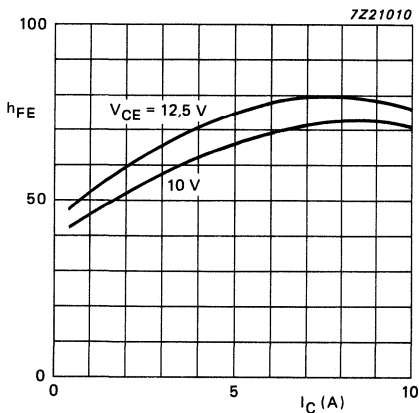


Fig. 3 D.C. current gain versus collector current;  $T_h = 25\text{ }^\circ\text{C}$ . Typical values.

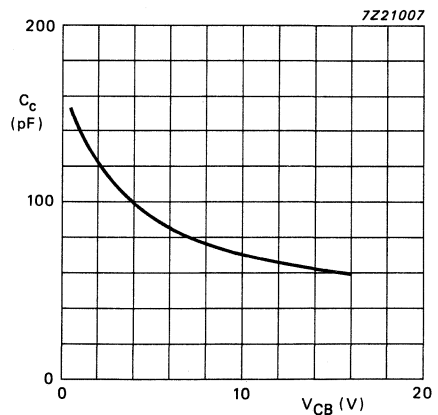
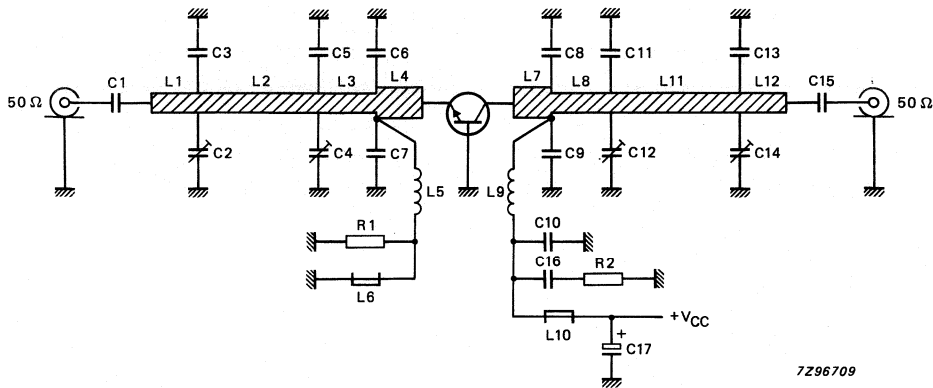


Fig. 4 Output capacitance versus  $V_{CB}$ ;  $I_E = i_e = 0$ ; typical values.

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-base circuit; class-B);  $f = 900$  MHz;  $T_h = 25$  °C

mode of operation	$V_{CB}$ V	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	12,5	22	> 5,5 typ. 7,0	> 50 typ. 60



7Z96709

Fig. 5 Class-B test circuit at  $f = 900$  MHz.

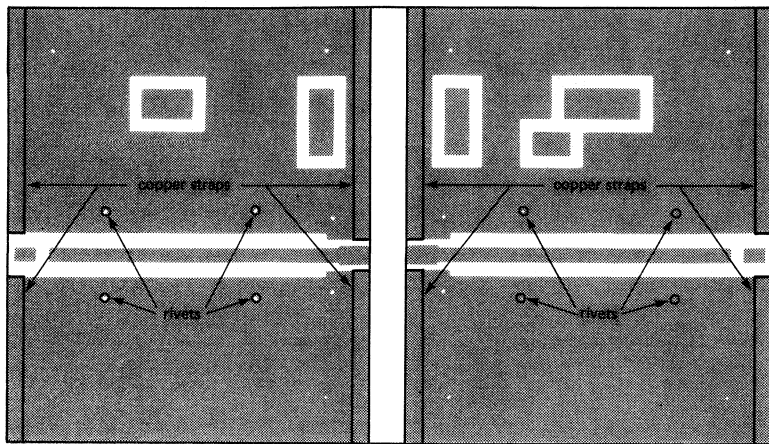
## List of components:

- C1 = C15 = 47 pF multilayer ceramic chip capacitor\*  
 C2 = C4 = C12 = C14 = 1,4 - 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)  
 C3 = 3,3 pF multilayer ceramic chip capacitor\*  
 C5 = C11 = C13 = 6,2 pF multilayer ceramic chip capacitor\*  
 C6 = C7 = 6,2 pF multilayer ceramic chip capacitor\*\*  
 C8 = 7,5 pF multilayer ceramic chip capacitor\*\*  
 C9 = 8,2 pF multilayer ceramic chip capacitor\*\*  
 C10 = 24 pF multilayer ceramic chip capacitor  
 C16 = 3 × 100 nF multilayer ceramic chip capacitor  
 C17 = 2,2 μF (35 V) electrolytic capacitor  
 L1 = L12 = 50 Ω stripline (9 mm × 2,4 mm)  
 L2 = L11 = 50 Ω stripline (24 mm × 2,4 mm)  
 L3 = L8 = 50 Ω stripline (14 mm × 2,4 mm)  
 L4 = L7 = 43 Ω stripline (5 mm × 3 mm)  
 L5 = 88 nH; 9 turns Cu-wire (0,8 mm); int. dia. 3 mm; length 10 mm; leads 2 × 5 mm  
 L6 = L10 = Ferroxdure wideband h.f. choke; grade 3B (cat. no. 4312 020 36642)  
 L9 = 53 nH; 4 turns Cu-wire (1 mm); int. dia. 4 mm; length 5,5 mm; leads 2 × 5 mm  
 R1 = 1 Ω ± 10%; 0,25 W, metal film resistor  
 R2 = 10 Ω ± 10%; 0,25 W, metal film resistor

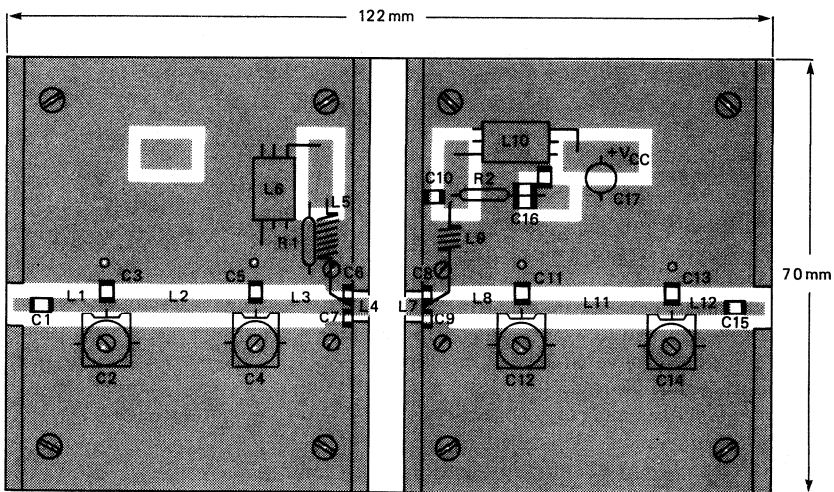
The striplines are on a double Cu-clad printed circuit board with P.T.F.E. fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch.

\* American Technical Ceramics capacitor type 100B or capacitor of the same quality.

\*\* Idem type 100 A.



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7296711

Fig. 6 Printed circuit board and component lay-out for 900 MHz class-B test circuit.

The circuit and components are on one side of the P.T.F.E. fibre-glass board; the other side is unetched copper serving as a ground plane.

Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the bases to provide a direct contact between the copper on the component side and the ground plane.

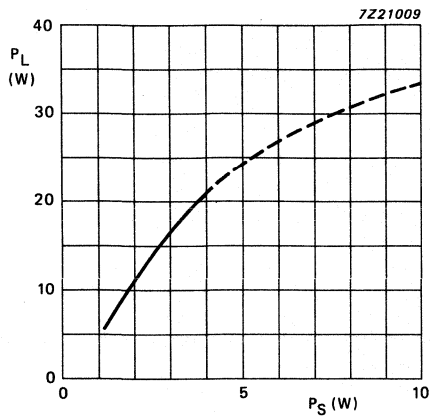


Fig. 7 Load power versus source power.

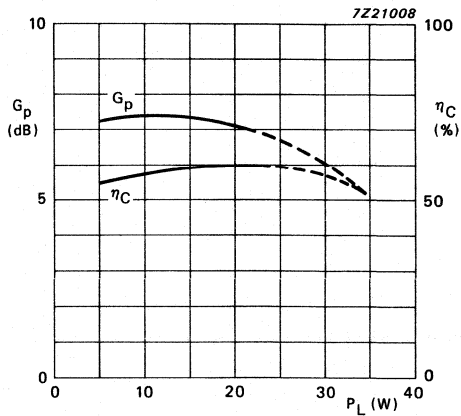


Fig. 8 Power gain and efficiency versus load power.

Condition for Figs 7 and 8:

$V_{CB} = 12,5 \text{ V}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; class-B operation;  
 $R_{th\text{ mb-h}} = 0,4 \text{ K/W}$ ; typical values.

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch ( $VSWR = 50$  through all phases) at rated load power under the following conditions:

$V_{CB} = 15,5 \text{ V}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0,4 \text{ K/W}$ .





## UHF POWER TRANSISTOR

NPN silicon planar epitaxial transistor in SOT171 envelope intended for use in class-B operated base station transmitters in the 900 MHz communications band.

### Features

- Internal matching to achieve an optimum wideband capability and stable operation
- Emitter-ballasting resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability

The transistor has a 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

RF performance up to  $T_h = 25^\circ\text{C}$  in common-base class-B circuit.

mode of operation	$V_{CB}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; CW	24	900	30	> 7.0	> 55

### MECHANICAL DATA

Dimensions in mm

Fig.1 SOT171.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

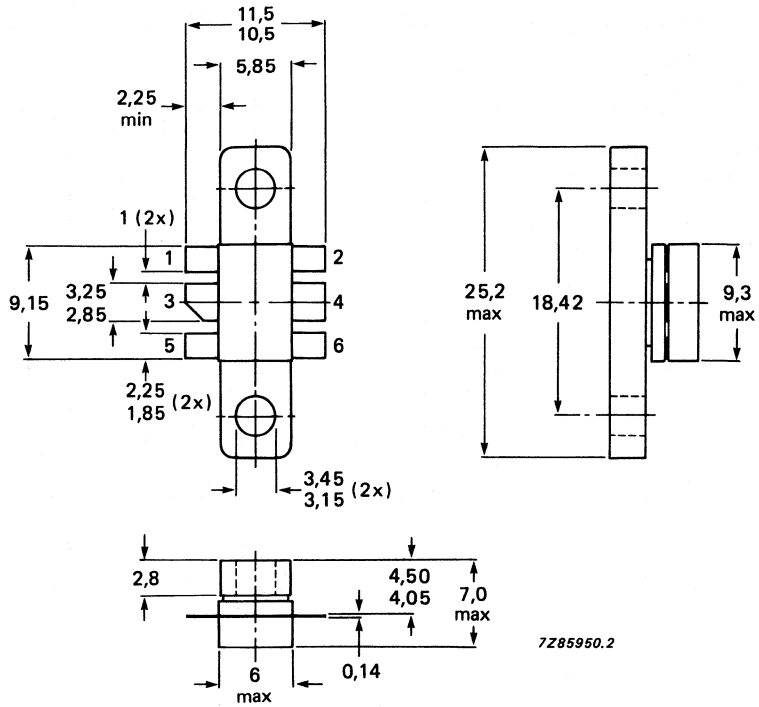
MECHANICAL DATA

Dimensions in mm

Fig.1 SOT171.

Pinning

- 1 Base
- 2 Base
- 3 Collector
- 4 Emitter
- 5 Base
- 6 Base



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Torque on screw: min. 0.6 Nm (6 kg.cm)

max. 0.75 Nm (7.5 kg.cm)

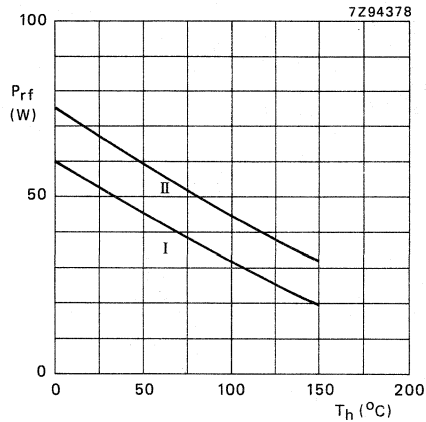
Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CB0}$	max.	50 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	27 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3.5 V
Collector current			
DC or average	$I_C$	max.	3 A
peak value; $f > 1$ MHz	$I_{CM}$	max.	9 A
Total power dissipation			
at $T_{mb} = 25$ °C; $f > 1$ MHz	$P_{tot}$	max.	60 W
Storage temperature range	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C



- I Continuous operation ( $f > 1$  MHz)
- II Short-time operating during mismatch ( $f > 1$  MHz)

Fig.2 Power/temperature derating curves.

**THERMAL RESISTANCE**

Dissipation = 60 W;  $T_{amb} = 25$  °C.

From junction to mounting base (RF operation)	$R_{th\ j-mb}$	max.	2.9 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0.4 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

Collector-base breakdown voltage  
open emitter;  $I_C = 50\text{ mA}$

$V_{(BR)CBO}$  min. 50 V

Collector-emitter breakdown voltage  
open base;  $I_C = 100\text{ mA}$

$V_{(BR)CEO}$  min. 27 V

Emitter-base breakdown voltage  
open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO}$  min. 3.5 V

Collector-emitter leakage current  
 $V_{BE} = 0$ ;  $V_{CE} = 27\text{ V}$

$I_{CES}$  max. 10 mA

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$E_{SBR}$  min. 4 mJ

DC current gain

$V_{CE} = 20\text{ V}$ ;  $I_C = 2\text{ A}$

$h_{FE}$  min. 15

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = i_e = 0$ ;  $V_{CB} = 24\text{ V}$

$C_c$  typ. 44 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_E = 0$ ;  $V_{CB} = 24\text{ V}$

$C_{rb}$  typ. 14 pF

Collector-flange capacitance

$C_{cf}$  typ. 2 pF

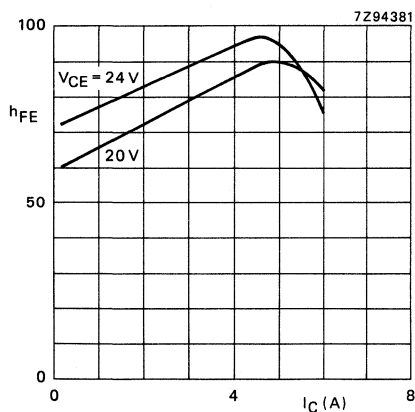


Fig.3 DC current gain as a function of collector current;  $T_j = 25\text{ }^\circ\text{C}$ .

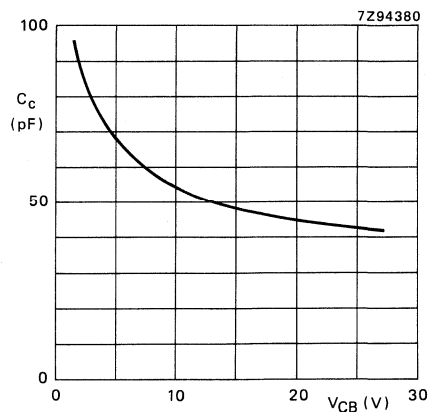
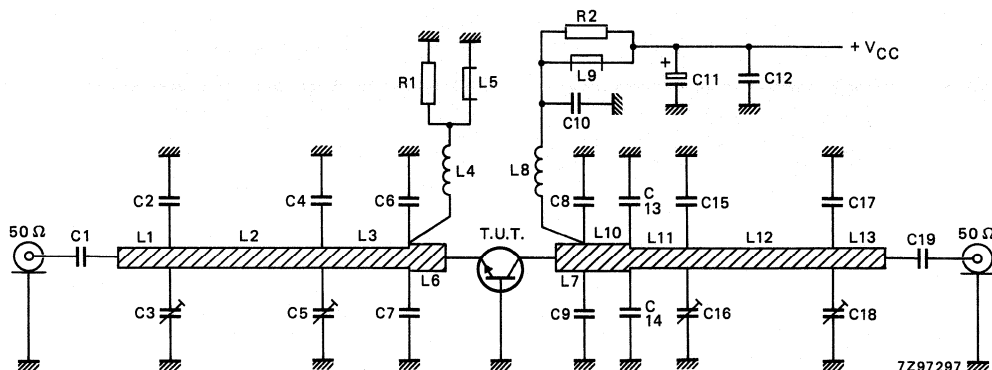


Fig.4 Collector capacitance as a function of  $V_{CB}$ ;  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ .

## APPLICATION INFORMATION

RF performance at  $T_h = 25\text{ }^\circ\text{C}$  in common-base class-B circuit.

mode of operation	$V_{CB}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; CW	24	900	30	> 7.0 typ. 8.0	> 55 typ. 63

Fig. 5 Class-B test circuit at  $f = 900\text{ MHz}$ .

List of components:

- C1 = C10 = C19 = 330 pF multilayer ceramic chip capacitor
- C2 = C4 = C13 = C14 = C15 = C17 = 6.2 pF multilayer ceramic chip capacitor\*
- C3 = C5 = C16 = C18 = 1.4 to 5.5 pF dielectric trimmer (cat. no. 2222 809 09001)
- C6 = 6.2 pF multilayer ceramic chip capacitor\*\*
- C7 = C8 = C9 = 6.8 pF multilayer ceramic chip capacitor\*
- C11 = 2.2  $\mu\text{F}$  (63 V) electrolytic capacitor
- C12 = 3 x 100 nF multilayer ceramic chip capacitor in parallel
- L1 = L13 = 50  $\Omega$  stripline (9.0 mm x 2.4 mm)
- L2 = 50  $\Omega$  stripline (24.0 mm x 2.4 mm)
- L3 = 50  $\Omega$  stripline (13.0 mm x 2.4 mm)
- L4 = 250 nH; 9 turns closely wound enamelled Cu-wire (1.0 mm) int. dia. 4 mm; leads 2 x 7 mm
- L5 = L9 = Ferroxcube wide-band HF choke, grade 3B (cat. no. 4312 020 26642)
- L6 = 43  $\Omega$  stripline (5.5 mm x 3.0 mm)
- L7 = 43  $\Omega$  stripline (3.0 mm x 3.0 mm)
- L8 = 65 nH; 5 turns closely wound enamelled Cu-wire (1.0 mm) int. dia. 4 mm; leads 2 x 7 mm
- L10 = 43  $\Omega$  stripline (7.5 mm x 3.0 mm)
- L11 = 50  $\Omega$  stripline (8.0 mm x 2.4 mm)
- L12 = 50  $\Omega$  stripline (24.0 mm x 2.4 mm)
- R1 = 1  $\Omega \pm 5\%$  (0.25 W) metal film resistor
- R2 = 10  $\Omega \pm 5\%$  (0.25 W) metal film resistor

The striplines are on a double Cu-clad printed circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch.

\* Americal Technical Ceramics capacitor type 100B or capacitor of the same quality.

\*\* Idem type 100A.

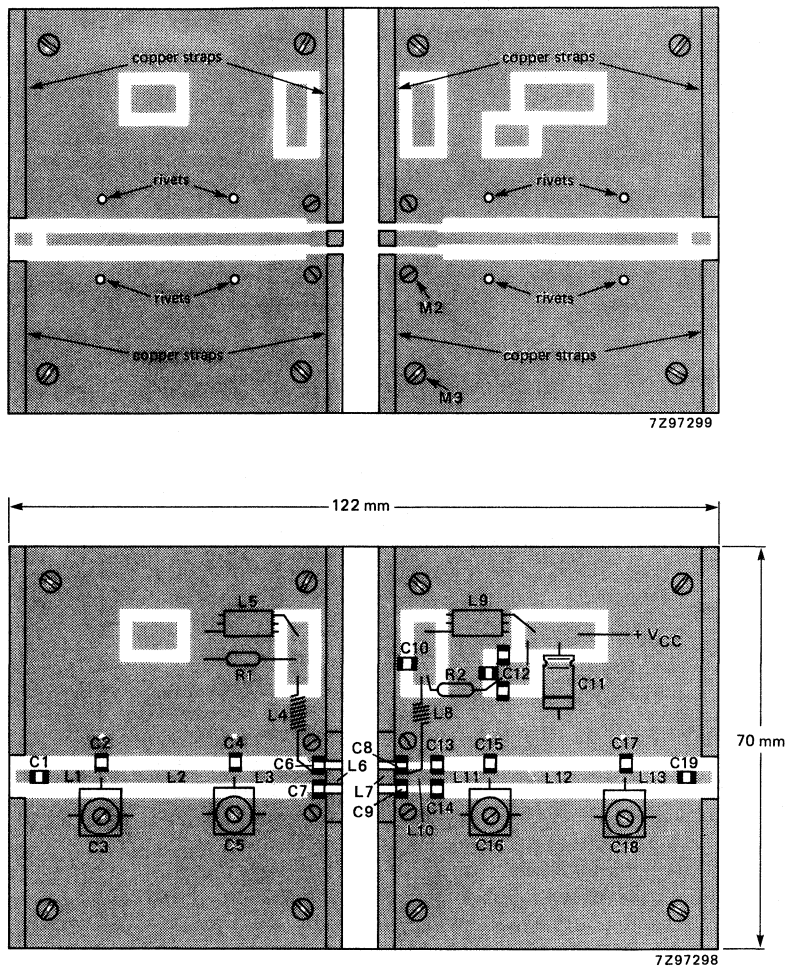


Fig.6 Printed circuit board and component layout for 900 MHz class-B test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board; the other side is unetched copper serving as a ground plane. Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the bases to provide a direct contact between the copper on the component side and the ground plane.

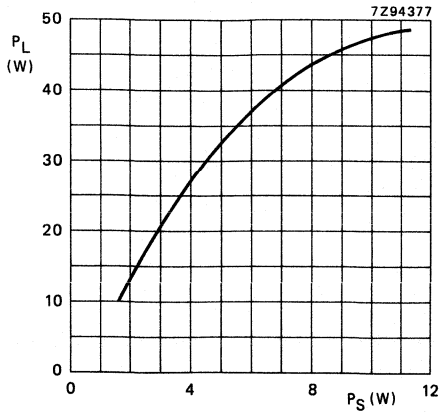


Fig.7 Load power as a function of source power.

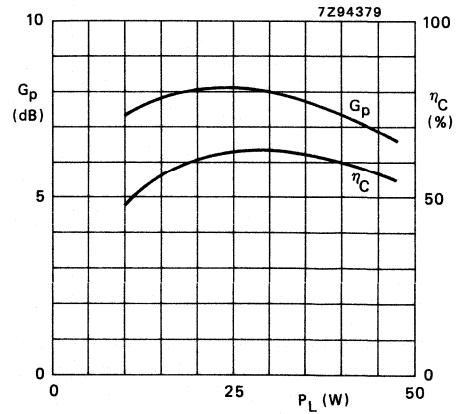


Fig.8 Power gain and efficiency as functions of load power.

Conditions for Figs 7 and 8:

Typical values;  $V_{CB} = 24$  V;  $f = 900$  MHz;  $T_h = 25$  °C; class-B operation;  $R_{th\ mb-h} = 0.4$  K/W.

#### RUGGEDNESS

The BLV97 is capable of withstanding a full load mismatch (VSWR = 50 through all phases) at rated load power and supply voltage; when  $T_h = 25$  °C and  $R_{th\ mb-h} = 0.4$  K/W.

#### INPUT AND LOAD IMPEDANCES

$\bar{Z}_i = 1.6 + j 4.4 \Omega$  and  $\bar{Z}_L = 1.20 + j 3.0 \Omega$  (series components).

Conditions:  $V_{CB} = 24$  V;  $P_L = 30$  W;  $f = 900$  MHz,  $T_h = 25$  °C; class-B operation;  $R_{th\ mb-h} = 0.4$  K/W; typical values.





Data sheet	
status	Product specification
date of issue	October 1990

# BLV97CE

## UHF power transistor

**FEATURES**

- Internal input matching to achieve high power gain
- Ballasting resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability

**DESCRIPTION**

NPN silicon planar epitaxial transistor in a SOT171 envelope, intended for common emitter, class-AB operation in radio transmitters for the 960 MHz communications band. The transistor has a 6-lead flange envelope, with a ceramic cap. All leads are isolated from the flange.

**QUICK REFERENCE DATA**

RF performance up to  $T_h = 25\text{ }^\circ\text{C}$  in a common emitter class-AB circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
c.w. class-AB	960	24	35	> 7	> 50

**MECHANICAL DATA**

SOT171 - see Fig.1.

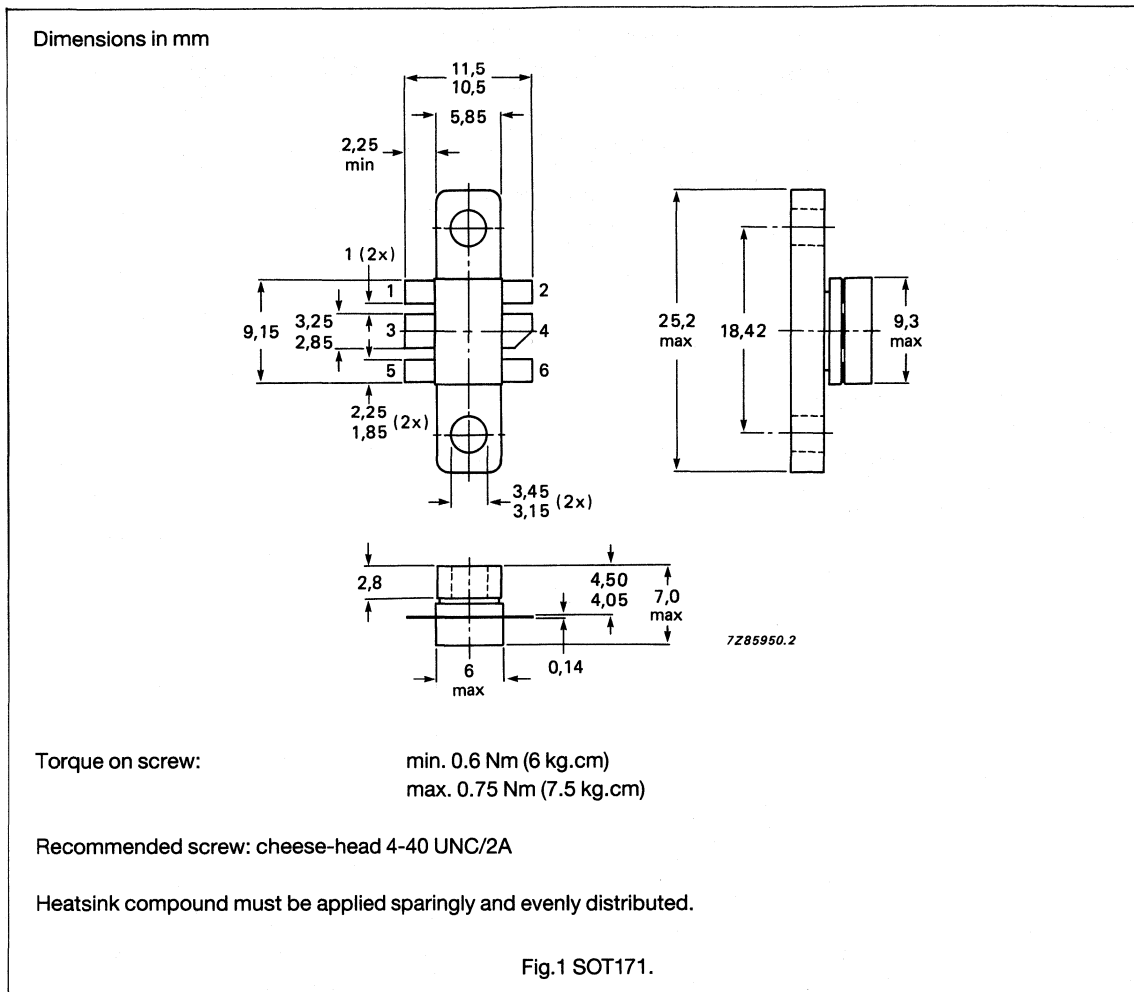
**WARNING**

Product and environmental safety - toxic materials
<p><b>This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions.</b></p> <p><b>After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.</b></p>

# UHF power transistor

# BLV97CE

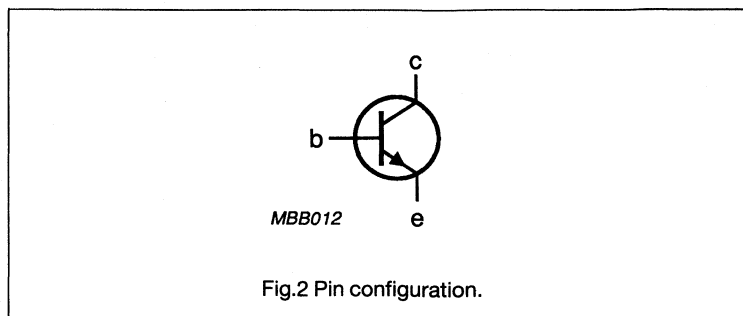
## MECHANICAL DATA



## PINNING

PIN	DESCRIPTION
1	emitter
2	emitter
3	base
4	collector
5	emitter
6	emitter

## PIN CONFIGURATION



# UHF power transistor

# BLV97CE

## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector base voltage	open emitter	–	50	V
V <sub>CEO</sub>	collector emitter voltage	open base	–	27	V
V <sub>EBO</sub>	emitter base voltage	open collector	–	3.5	V
I <sub>C</sub>	collector current	DC or average	–	3	A
I <sub>CM</sub>	collector current	peak value f > 1 MHz	–	9	A
P <sub>tot</sub>	total power dissipation	f > 1 MHz T <sub>mb</sub> = 25 °C	–	70	W
T <sub>stg</sub>	storage temperature		–65	150	°C
T <sub>j</sub>	operating junction temperature		–	200	°C

## THERMAL RESISTANCE

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
R <sub>thj-mb</sub>	from junction to mounting base (RF)		–	2.3	K/W
R <sub>th mb-h</sub>	from mounting base to heatsink		–	0.4	K/W

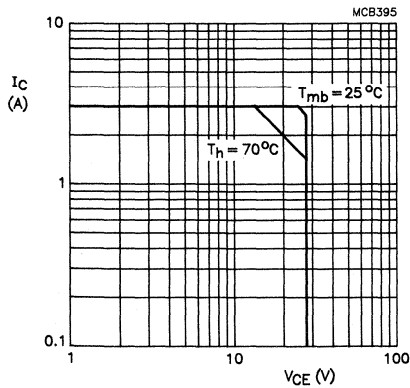


Fig.3 DC SOAR.

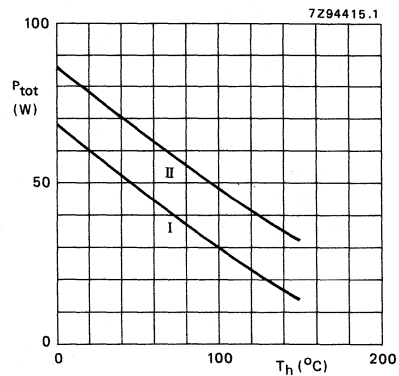


Fig.4 Power/temperature derating;  
(I): DC or RF operation;  
(II): short-term operation during mismatch.

## UHF power transistor

## BLV97CE

## CHARACTERISTICS

at  $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter $I_C = 50\text{ mA}$	50	–	–	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base $I_C = 100\text{ mA}$	27	–	–	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector $I_E = 10\text{ mA}$	3.5	–	–	V
$I_{CES}$	collector leakage current	$V_{BE} = 0$ $V_{CE} = 27\text{ V}$	–	–	10	mA
$h_{FE}$	DC current gain	$I_C = 2\text{ A}$ $V_{CE} = 20\text{ V}$	15	–	–	
$C_C$	collector capacitance at $f = 1\text{ MHz}$	$I_E = I_B = 0$ $V_{CB} = 25\text{ V}$	–	44	–	pF
$C_{re}$	feedback capacitance at $f = 1\text{ MHz}$	$I_C = 0$ $V_{CE} = 25\text{ V}$	–	30	–	pF
$C_{cf}$	collector-flange capacitance		–	2	–	pF

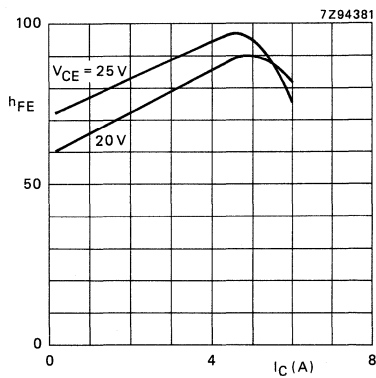


Fig.5 DC current gain as a function of collector current; typical values.

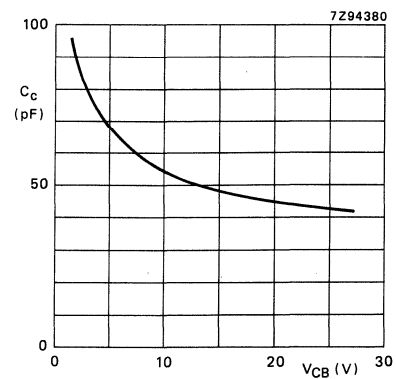


Fig.6 Output capacitance as a function of collector-base voltage; typical values.

## UHF power transistor

BLV97CE

## APPLICATION INFORMATION

RF performance in a common emitter test circuit.

 $T_h = 25^\circ\text{C}$ ,  $R_{th\ mb-h} = 0.4\ \text{K/W}$  unless otherwise specified.

MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$I_{C(ZS)}$ (mA)	$P_L$ (W)	$G_p$ (dB)	$\eta_c$ (%)
c.w. class-AB	960	24	60	35	> 7 typ. 8.5	> 50 typ. 55

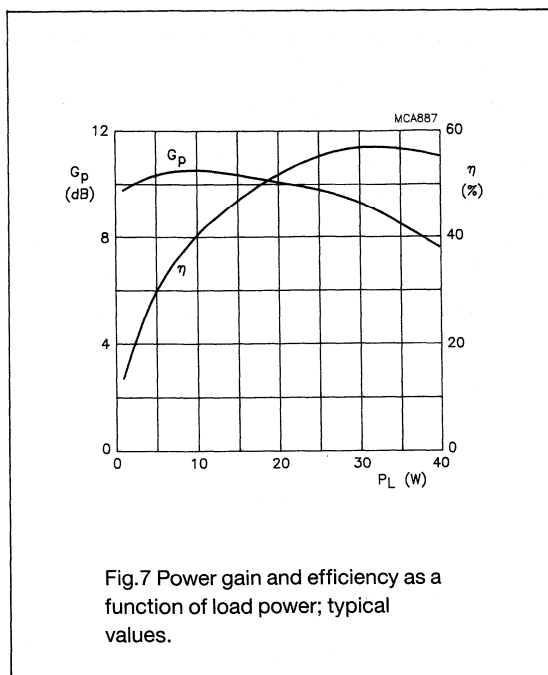


Fig.7 Power gain and efficiency as a function of load power; typical values.

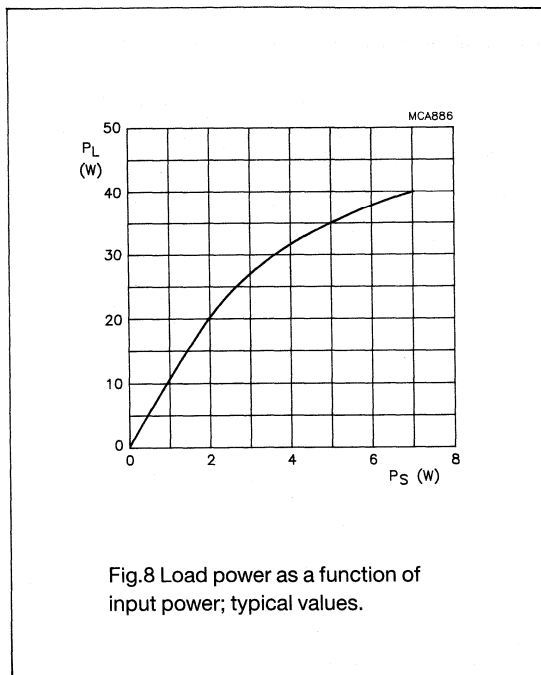


Fig.8 Load power as a function of input power; typical values.

## Ruggedness in class-AB operation

The BLV97CE is capable of withstanding a load mismatch corresponding to  $V_{SWR} = 50$  through all phases, under the following conditions:  $V_{CE} = 24\ \text{V}$ ;  $I_{C(ZS)} = 120\ \text{mA}$ ;  $f = 960\ \text{MHz}$  at rated output power.

## UHF power transistor

## BLV97CE

## APPLICATION INFORMATION (continued)

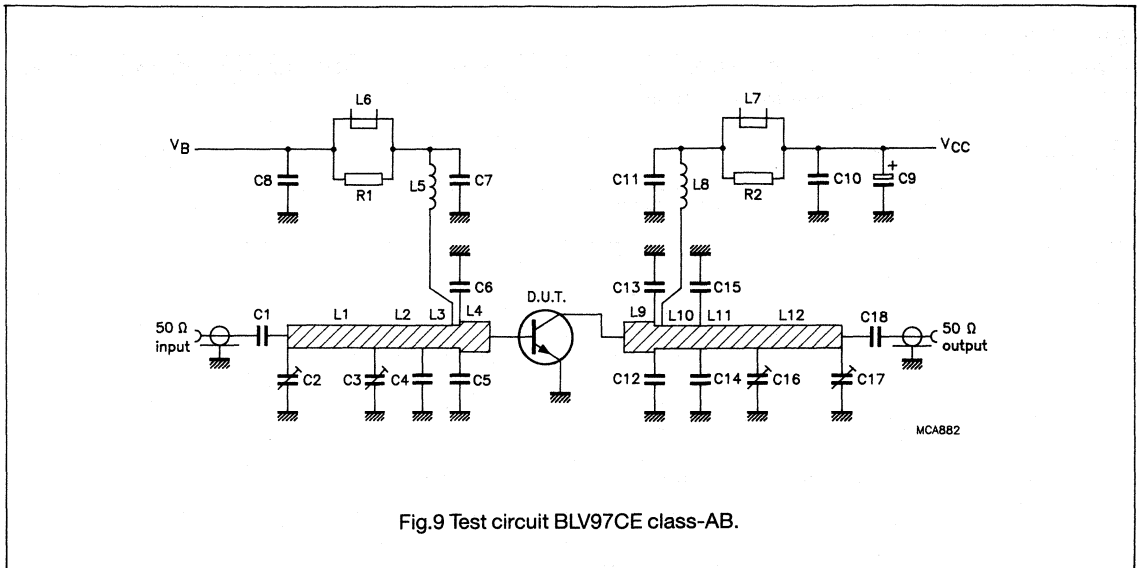


Fig.9 Test circuit BLV97CE class-AB.

**UHF power transistor****BLV97CE****APPLICATION INFORMATION** (continued)**List of components** (Fig. 9)

DESIGNATION	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C18	multilayer ceramic chip capacitor note 1	33 pF		
C2, C3, C16, C17	film dielectric trimmer	1.4 to 5.5 pF		2222 809 09001
C5, C6	multilayer ceramic chip capacitor note 2	3.3 pF		
C7, C11	multilayer ceramic chip capacitor note 1	10 pF		
C8	multilayer ceramic chip capacitor	100 nF		
C9	35 V solid aluminium capacitor	2.2 $\mu$ F		2222 128 50228
C10	multilayer ceramic chip capacitor	3 x 100 nF in parallel		
C12, C13	multilayer ceramic chip capacitor note 2	12 pF		
C14, C15	multilayer ceramic chip capacitor note 1	3.3 pF		
L1, L12	microstrip note 3	50 $\Omega$	26 x 2.4 mm	
L2, L3	microstrip note 3	50 $\Omega$	9.5 x 2.4 mm	
L4	microstrip note 3	42.6 $\Omega$	6.0 x 3.0 mm	
L5	3 turns enamelled 1 mm copper wire	30 nH	int. dia. 4 mm length 3 mm leads 2 x 5mm	
L6, L7	grade 3B ferroxcube wide-band RF choke			4312 020 36642
L8	4 turns enamelled 1 mm copper wire	45 nH	int. dia. 4 mm length 4 mm leads 2 x 5 mm	
L9	microstrip note 3	42.6 $\Omega$	4.0 x 3.0 mm	
L10	microstrip note 3	50 $\Omega$	9.0 x 2.4 mm	
L11	microstrip note 3	50 $\Omega$	13.5 x 2.4 mm	
R1, R2	1 W metal film resistor	10 $\Omega$		2322 153 51009

**Notes**

1. ATC capacitor type 100B or capacitor of the same quality.
2. ATC capacitor type 100A or capacitor of the same quality.
3. The microstrips are on a double copper-clad PCB with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch.

## UHF power transistor

BLV97CE

## APPLICATION INFORMATION (continued)

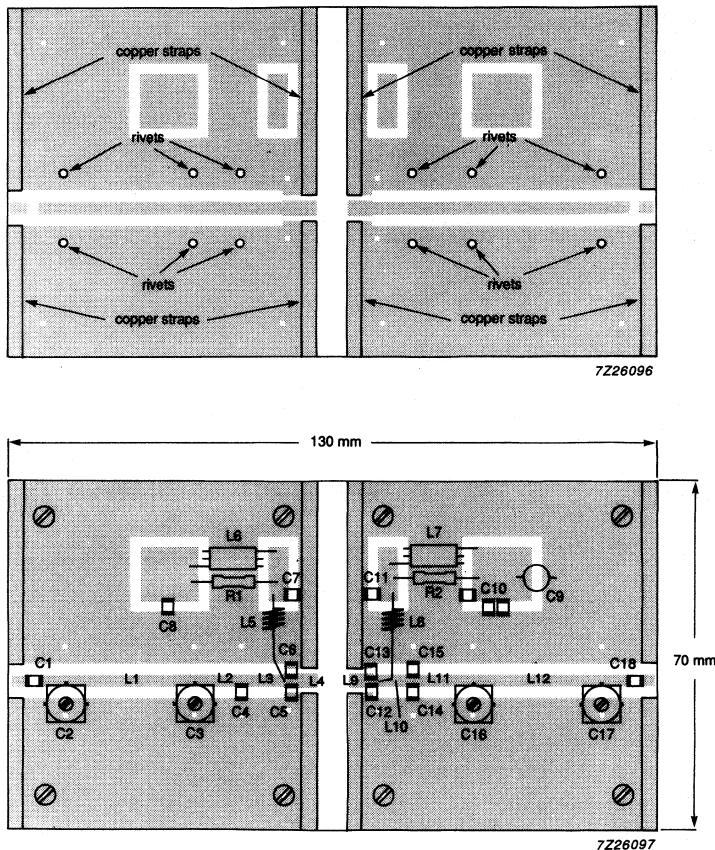


Fig.10 Printed circuit board and component layout for 960 MHz test circuit.

The circuit and components are located on one side of the PTFE fibre-glass board, the other side being fully metallized, to serve as an earth. Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the emitters, to provide a direct contact between the component side and the ground plane.



## UHF power transistor

## BLV97CE

## APPLICATION INFORMATION (continued)

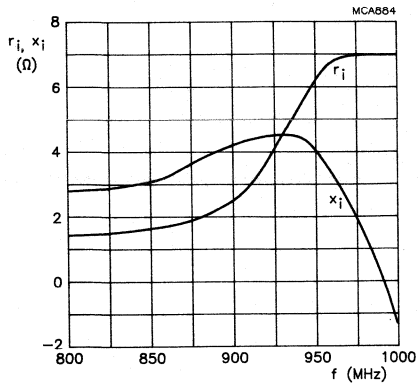


Fig.11 Input impedance; series components;  $V_{CE} = 24$  V;  $P_L = 35$  W;  $R_{th\ mb-h} = 0.4$  K/W; typical values.

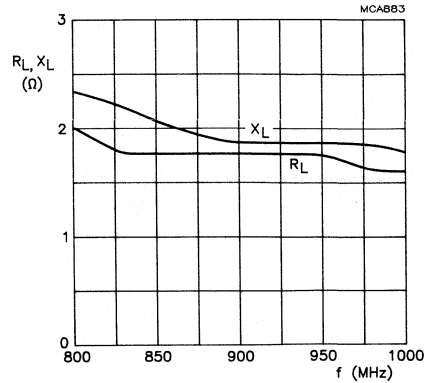


Fig.12 Load impedance; series components;  $V_{CE} = 24$  V;  $P_L = 35$  W;  $R_{th\ mb-h} = 0.4$  K/W; typical values.

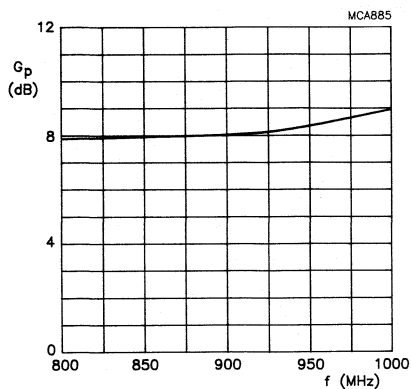


Fig.13 Power gain; class-AB operation;  $V_{CE} = 24$  V;  $P_L = 35$  W;  $R_{th\ mb-h} = 0.4$  K/W; typical values.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor in SOT-171 envelope intended for use in class-B operated base station transmitters in the 900 MHz communications band.

### Features

- internal matching to achieve an optimum wideband capability and stable operation.
- emitter ballasting resistors for an optimum temperature profile.
- gold metallization ensures excellent reliability.

The transistor has a 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in common-base class-B circuit.

mode of operation	$V_{CB}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	24	900	14	> 8,5	> 55

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-171.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

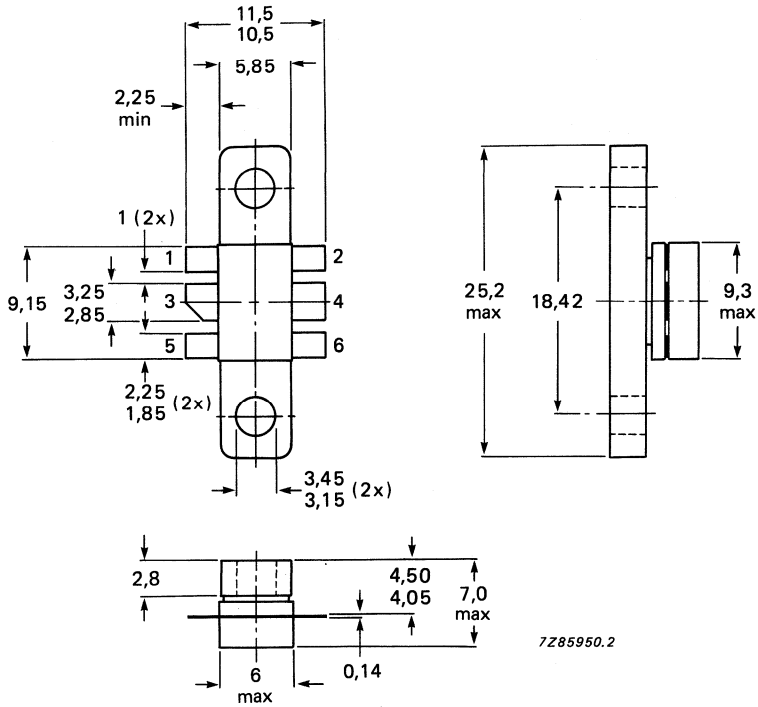
MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-171.

Pinning:

- 1 Base
- 2 Base
- 3 Collector
- 4 Emitter
- 5 Base
- 6 Base



Torque on screw: min. 0,6 Nm (6 kg.cm)  
 max. 0,75 Nm (7,5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CB0}$	max.	50 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	27 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3,5 V
Collector current			
d.c. or average	$I_C$	max.	1,5 A
peak value; $f > 1$ MHz	$I_{CM}$	max.	4,5 A
Total power dissipation			
at $T_{mb} = 25$ °C; $f > 1$ MHz	$P_{tot}$	max.	40 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

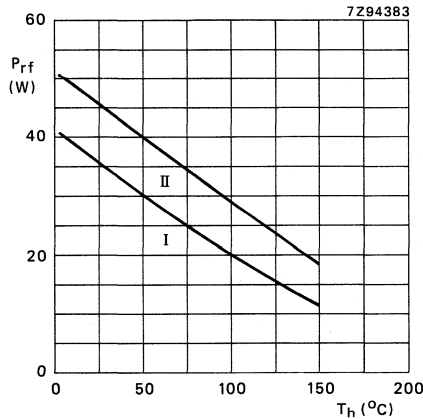


Fig. 2 Power/temperature derating curves.

I Continuous operation ( $f > 1$  MHz)

II Short-time operation during mismatch ( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 40 W;  $T_{amb} = 25$  °C

From junction to mounting base  
(r.f. operation)

$R_{th\ j-mb}$  max. 4,4 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  max. 0,4 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 25\text{ mA}$

$V_{(BR)CBO}$  min. 50 V

Collector-emitter breakdown voltage  
open base;  $I_C = 50\text{ mA}$

$V_{(BR)CEO}$  min. 27 V

Emitter-base breakdown voltage  
open collector;  $I_E = 5\text{ mA}$

$V_{(BR)EBO}$  min. 3,5 V

Collector-emitter leakage current  
 $V_{BE} = 0$ ;  $V_{CE} = 27\text{ V}$

$I_{CES}$  max. 5 mA

Second breakdown energy  
 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ ;  $R_{BE} = 10\text{ }\Omega$

$E_{SBR}$  min. 2 mJ

D.C. current gain  
 $V_{CE} = 20\text{ V}$ ;  $I_C = 1\text{ A}$

$h_{FE}$  min. 15

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = i_e = 0$ ;  $V_{CB} = 24\text{ V}$

$C_c$  typ. 23 pF

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_E = 0$ ;  $V_{CB} = 24\text{ V}$

$C_{rb}$  typ. 7 pF

Collector-flange capacitance

$C_{cf}$  typ. 2 pF

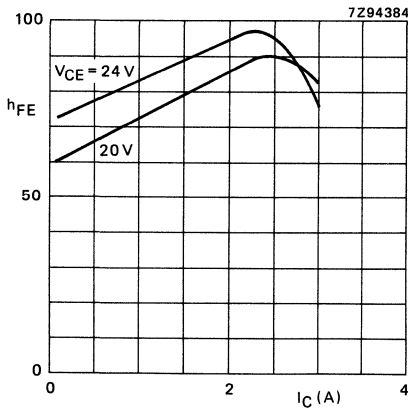


Fig. 3 D.C. current gain versus collector current;  $T_j = 25\text{ }^\circ\text{C}$ .

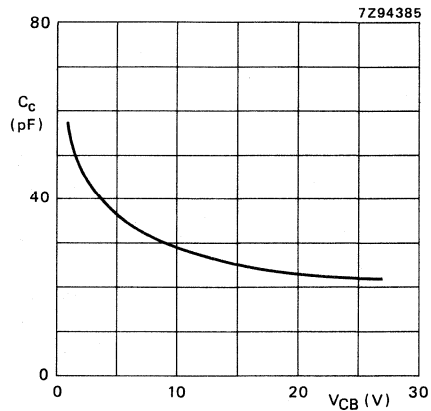
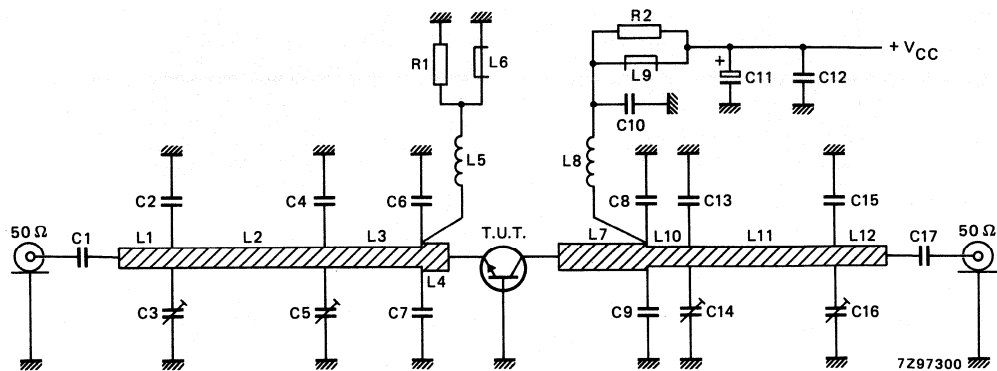


Fig. 4 Output capacitance versus  $V_{CB}$ ;  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ .

## APPLICATION INFORMATION

R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$  in common-base class-B circuit.

mode of operation	$V_{CB}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	24	900	14	> 8,5 typ. 10,0	> 55 typ. 65

Fig. 5 Class-B test circuit at  $f = 900\text{ MHz}$ .

## List of components:

- C1 = C10 = C17 = 330 pF multilayer ceramic chip capacitor  
 C2 = C13 = 3,3 pF multilayer ceramic chip capacitor\*  
 C3 = C5 = C14 = C16 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)  
 C4 = C8 = C9 = C15 = 6,2 pF multilayer ceramic chip capacitor\*  
 C6 = C7 = 6,2 pF multilayer ceramic chip capacitor\*\*  
 C11 = 2,2  $\mu\text{F}$  (63 V) electrolytic capacitor  
 C12 = 3 x 100 nF multilayer ceramic chip capacitors in parallel  
 L1 = L12 = 50  $\Omega$  stripline (9,0 mm x 2,4 mm)  
 L2 = L11 = 50  $\Omega$  stripline (24,0 mm x 2,4 mm)  
 L3 = 50  $\Omega$  stripline (16,0 mm x 2,4 mm)  
 L4 = 43  $\Omega$  stripline (3,0 mm x 3,0 mm)  
 L5 = 88 nH; 9 turns closely wound enamelled Cu-wire (0,8 mm); int. dia. 3 mm length 12 mm; leads 2 x 5 mm  
 L6 = L9 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36642)  
 L7 = 43  $\Omega$  stripline (14,5 mm x 3,0 mm)  
 L8 = 53 nH; 4 turns enamelled Cu-wire (1,0 mm); int. dia. 4 mm; length 5 mm; leads 2 x 5 mm  
 L10 = 50  $\Omega$  stripline (4,5 mm x 2,4 mm)  
 R1 = 1  $\Omega \pm 5\%$  (0,25 W) metal film resistor  
 R2 = 10  $\Omega \pm 5\%$  (0,25 W) metal film resistor

The striplines are on a double Cu-clad printed circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch.

\* AmericanTechnical Ceramics capacitor type 100B or capacitor of the same quality.

\*\* Idem type 100A.

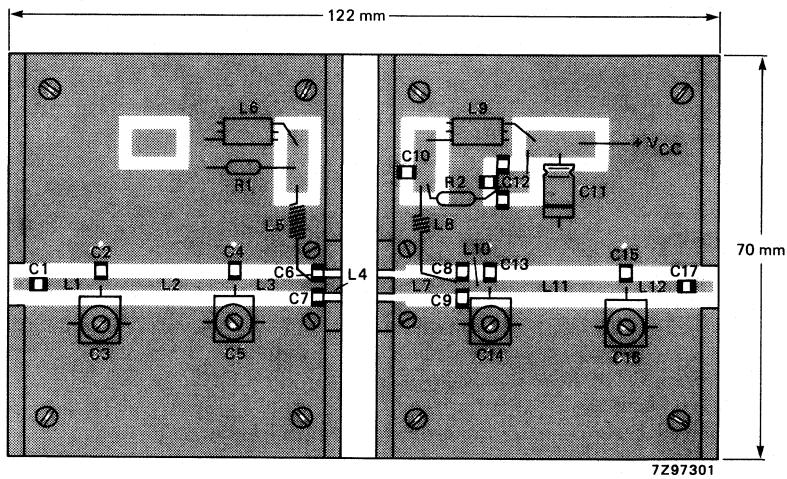
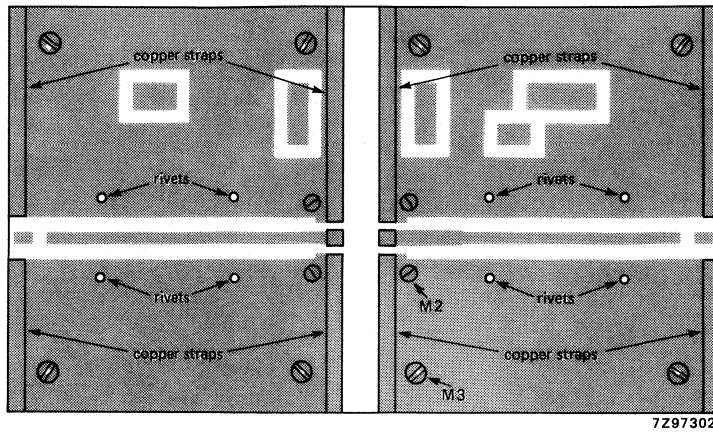


Fig. 6 Printed circuit board and component layout for 900 MHz class-B test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board; the other side is unetched copper serving as a ground plane. Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the bases to provide a direct contact between the copper on the component side and the ground plane.



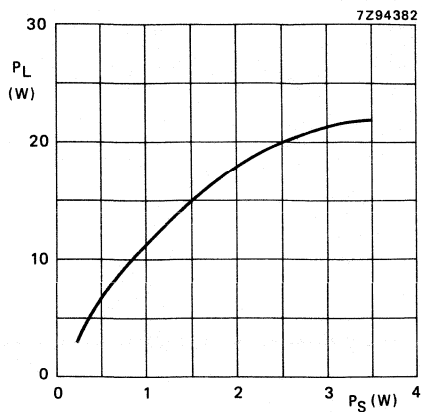


Fig. 7 Load power versus source power.

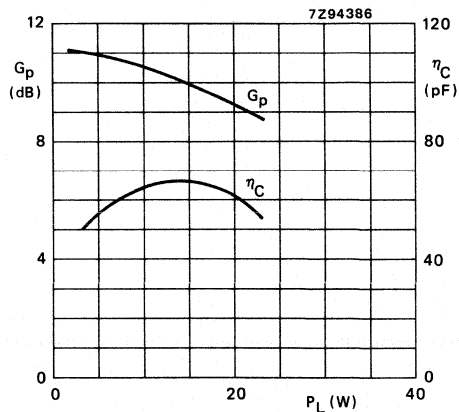


Fig. 8 Power gain and efficiency versus load power.

Conditions for Figs 7 and 8:

Typical values;  $V_{CB} = 24$  V;  $f = 900$  MHz;  $T_h = 25$  °C; class-B operation;  $R_{th\ mb-h} = 0,4$  K/W.

#### RUGGEDNESS

The BLV98 is capable of withstanding a full load mismatch (VSWR = 50 through all phases) at rated load power and supply voltage; when  $T_h = 25$  °C and  $R_{th\ mb-h} = 0,4$  K/W.

#### INPUT AND LOAD IMPEDANCES

$\bar{Z}_i = 5,1 + j 4,5 \Omega$  and  $\bar{Z}_L = 2,2 + j 3,0 \Omega$  (series components).

Conditions:  $V_{CB} = 24$  V;  $P_L = 14$  W;  $f = 900$  MHz,  $T_h = 25$  °C; class-B operation;  $R_{th\ mb-h} = 0,4$  K/W; typical values.



## Philips Components

Data sheet	
status	Product specification
date of issue	August 1990

# BLV98CE

## UHF power transistor

### FEATURES

- Internal input matching to achieve high power gain
- Implanted ballasting resistors an for optimum temperature profile
- Gold metallization ensures excellent reliability

### DESCRIPTION

NPN silicon planar epitaxial transistor in an SOT-171 envelope, intended for common emitter, class-AB operation in radio transmitters for the 960 MHz communications band. The transistor has a 6-lead flange envelope, with a ceramic cap. All leads are isolated from the flange.

### WARNING

#### Product and environmental safety - toxic materials

**This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions.**

**After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.**

### QUICK REFERENCE DATA

RF performance up to  $T_h = 25\text{ °C}$  in a common emitter class-AB circuit.

mode of operation	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>c</sub> (%)
c.w. class-AB	960	24	15	> 7.5	> 50

### MECHANICAL DATA

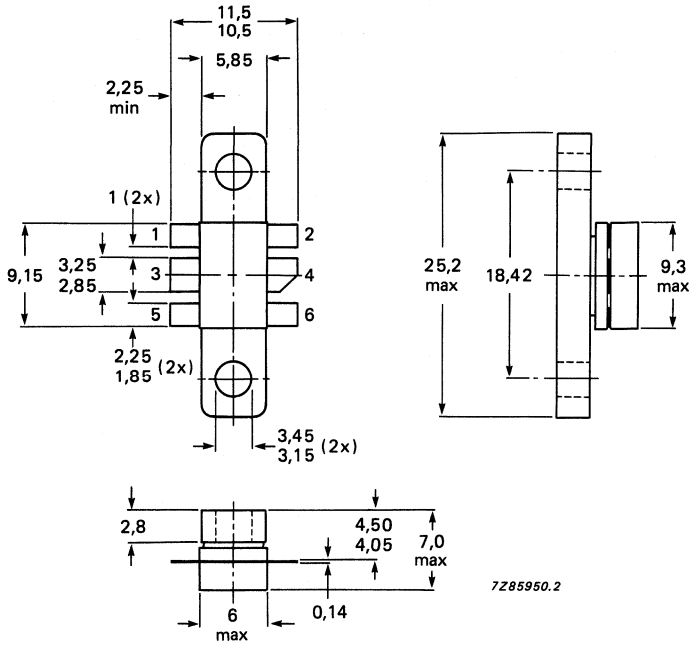
SOT171 - see Fig.1.

**UHF power transistor**

**BLV98CE**

**MECHANICAL DATA**

Dimensions in mm



Torque on screw: min. 0.6 Nm (6 kg.cm)  
max. 0.75 Nm (7.5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

Fig.1 SOT-171.

**PIN CONFIGURATION**

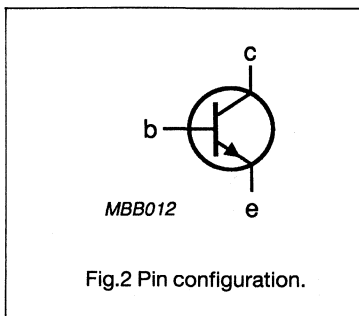


Fig.2 Pin configuration.

**PINNING**

PIN	DESCRIPTION
1	emitter
2	emitter
3	base
4	collector
5	emitter
6	emitter

# UHF power transistor

# BLV98CE

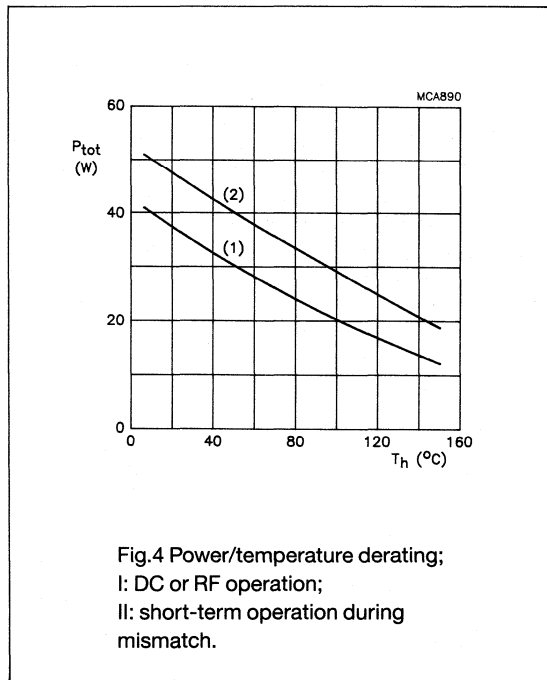
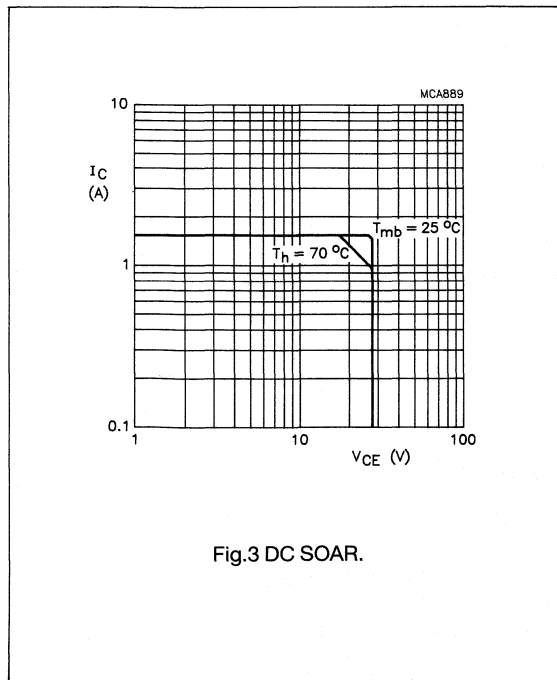
## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector base voltage	open emitter	–	50	V
$V_{CEO}$	collector emitter voltage	open base	–	27	V
$V_{EBO}$	emitter base voltage	open collector	–	3.5	V
$I_C$	collector current	DC or average	–	1.5	A
$I_{CM}$	collector current	peak value $f > 1$ MHz	–	4.5	A
$P_{tot}$	total power dissipation	$f > 1$ MHz $T_{mb} = 25$ °C	–	40	W
$T_{stg}$	storage temperature		–65	150	°C
$T_j$	operating junction temperature		–	200	°C

## THERMAL RESISTANCE

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$R_{thj-mb}$	from junction to mounting base (RF)		–	4.4	K/W
$R_{th mb-h}$	from mounting base to heatsink		–	0.4	K/W



## UHF power transistor

BLV98CE

## CHARACTERISTICS

at  $T_j = 25\text{ }^\circ\text{C}$  unless otherwise stated.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter $I_C = 25\text{ mA}$	50	—	—	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base $I_C = 50\text{ mA}$	27	—	—	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector $I_E = 5\text{ mA}$	3.5	—	—	V
$I_{CES}$	collector leakage current	$V_{BE} = 0$ $V_{CE} = 27\text{ V}$	—	—	5	mA
$h_{FE}$	DC current gain	$I_C = 1\text{ A}$ $V_{CE} = 20\text{ V}$	15	—	—	
$C_c$	collector capacitance at $f = 1\text{ MHz}$	$I_E = I_e = 0$ $V_{CB} = 24\text{ V}$	—	23	—	pF
$C_{re}$	feedback capacitance at $f = 1\text{ MHz}$	$I_C = 0$ $V_{CE} = 24\text{ V}$	—	14	—	pF
$C_{cf}$	collector-flange capacitance		—	2	—	pF

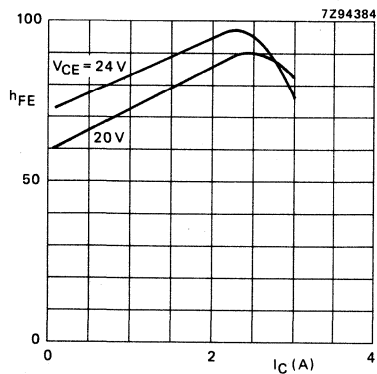
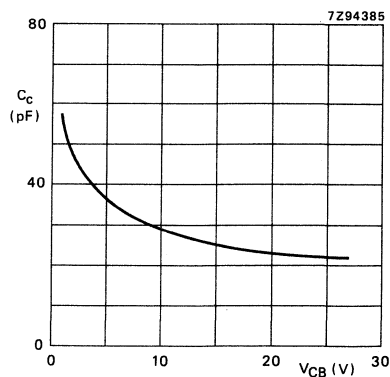


Fig.5 DC current gain as a function of collector current; typical values.

Fig.6 Output capacitance as a function of  $V_{CB}$ ; typical values.

## UHF power transistor

BLV98CE

## APPLICATION INFORMATION

RF performance in a common emitter test circuit.

$T_h = 25\text{ }^\circ\text{C}$ ,  $R_{th\text{ mb-h}} = 0.4\text{ K/W}$  unless otherwise specified.

mode of operation	f (MHz)	V <sub>CE</sub> (V)	I <sub>C(ZS)</sub> (mA)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
c.w. class-AB	960	24	30	15	> 7.5 typ. 8.5	> 50 typ. 55

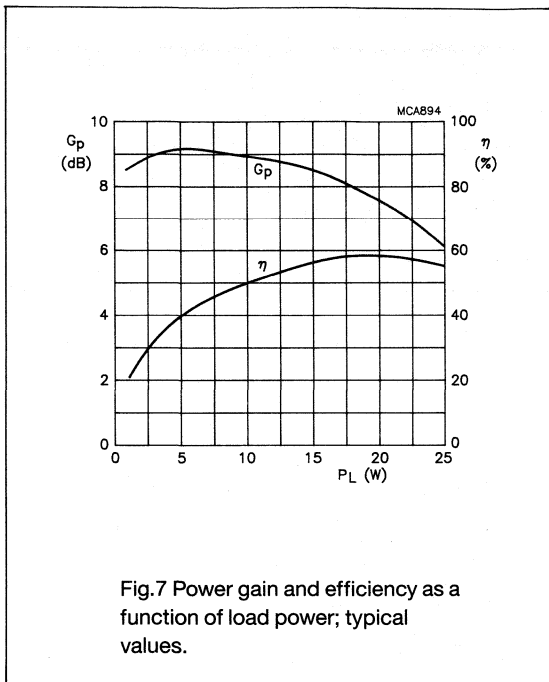


Fig.7 Power gain and efficiency as a function of load power; typical values.

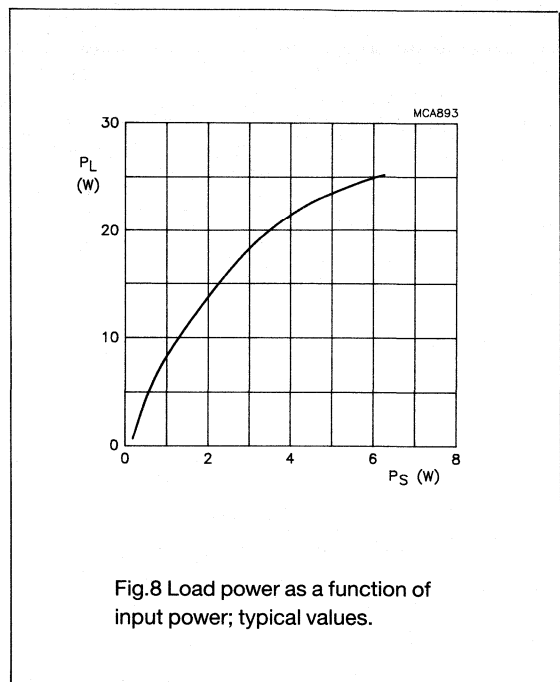


Fig.8 Load power as a function of input power; typical values.

## Ruggedness in class-AB operation

The BLV98CE is capable of withstanding a load mismatch corresponding to VSWR = 50 through all phases, under the following conditions:  $V_{CE} = 24\text{ V}$ ,  $I_{C(ZS)} = 30\text{ mA}$ ,  $f = 960\text{ MHz}$  at rated output power.

# UHF power transistor

# BLV98CE

## APPLICATION INFORMATION (continued)

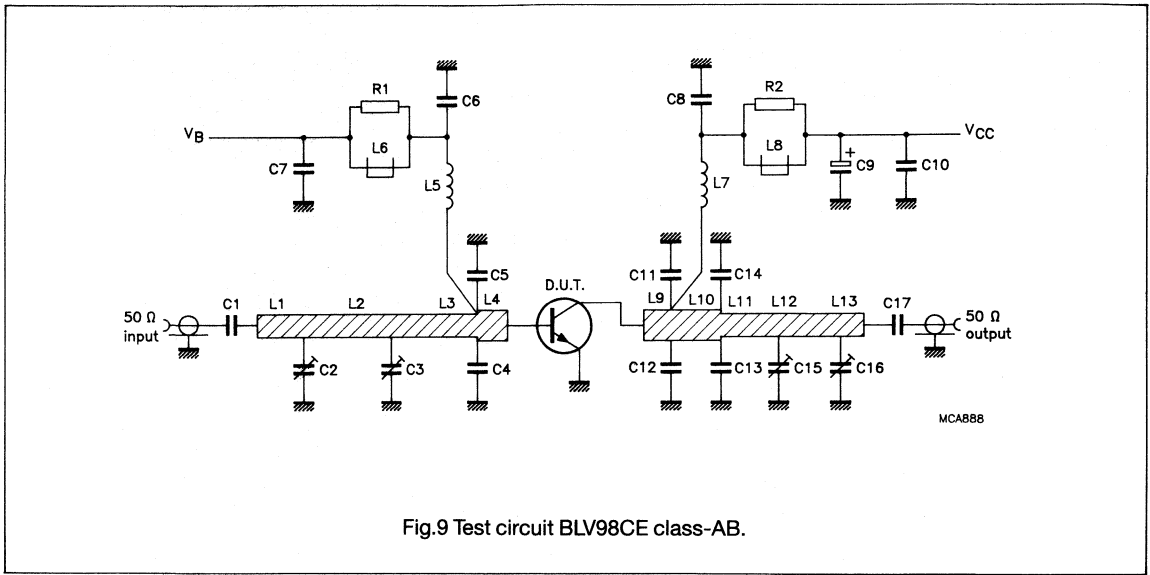


Fig.9 Test circuit BLV98CE class-AB.



**UHF power transistor****BLV98CE****APPLICATION INFORMATION** (continued)**List of components** (Fig. 9)

DESIGNATION	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C6, C7, C8, C17	multilayer ceramic chip capacitor	330 pF		
C2, C3, C15, C16	film dielectric trimmer	1.4 to 5.5 pF		2222 809 09001
C4, C5	multilayer ceramic chip capacitor note 1	4.3 pF		
C9	35 V solid aluminium capacitor	2.2 $\mu$ F		2222 128 50228
C10	multilayer ceramic chip capacitor	3 x 100 nF in parallel		
C11, C12	multilayer ceramic chip capacitor note 1	5.6 pF		
C13, C14	multilayer ceramic chip capacitor note 2	5.1 pF		
L1, L13	microstrip note 3	50 $\Omega$	9.0 x 2.4 mm	
L2, L12	microstrip note 3	50 $\Omega$	23.0 x 2.4 mm	
L3	microstrip note 3	50 $\Omega$	16.0 x 2.4 mm	
L4	microstrip note 3	43 $\Omega$	3.0 x 3.0 mm	
L5	3 turns enamelled 0.8 mm copper wire		int. dia. 3 mm length 5 mm leads 2 x 5 mm	
L6, L8	grade 3B ferroxcube wide-band RF choke			4312 020 36642
L7	4 turns enamelled 0.8 mm copper wire		int. dia. 4 mm length 5 mm leads 2 x 5 mm	
L9	microstrip note 3	43 $\Omega$	3.5 x 3.0 mm	
L10	microstrip note 3	43 $\Omega$	11.0 x 3.0 mm	
L11	microstrip note 3	50 $\Omega$	4.5 x 2.4 mm	
R1, R2	0.4 W metal film resistor	10 $\Omega$		2322 151 71009

**Notes**

1. ATC capacitor type 100A or capacitor of the same quality.
2. ATC capacitor type 100B or capacitor of the same quality.
3. The microstrips are on a double copper-clad PCB with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch.

## UHF power transistor

BLV98CE

## APPLICATION INFORMATION (continued)

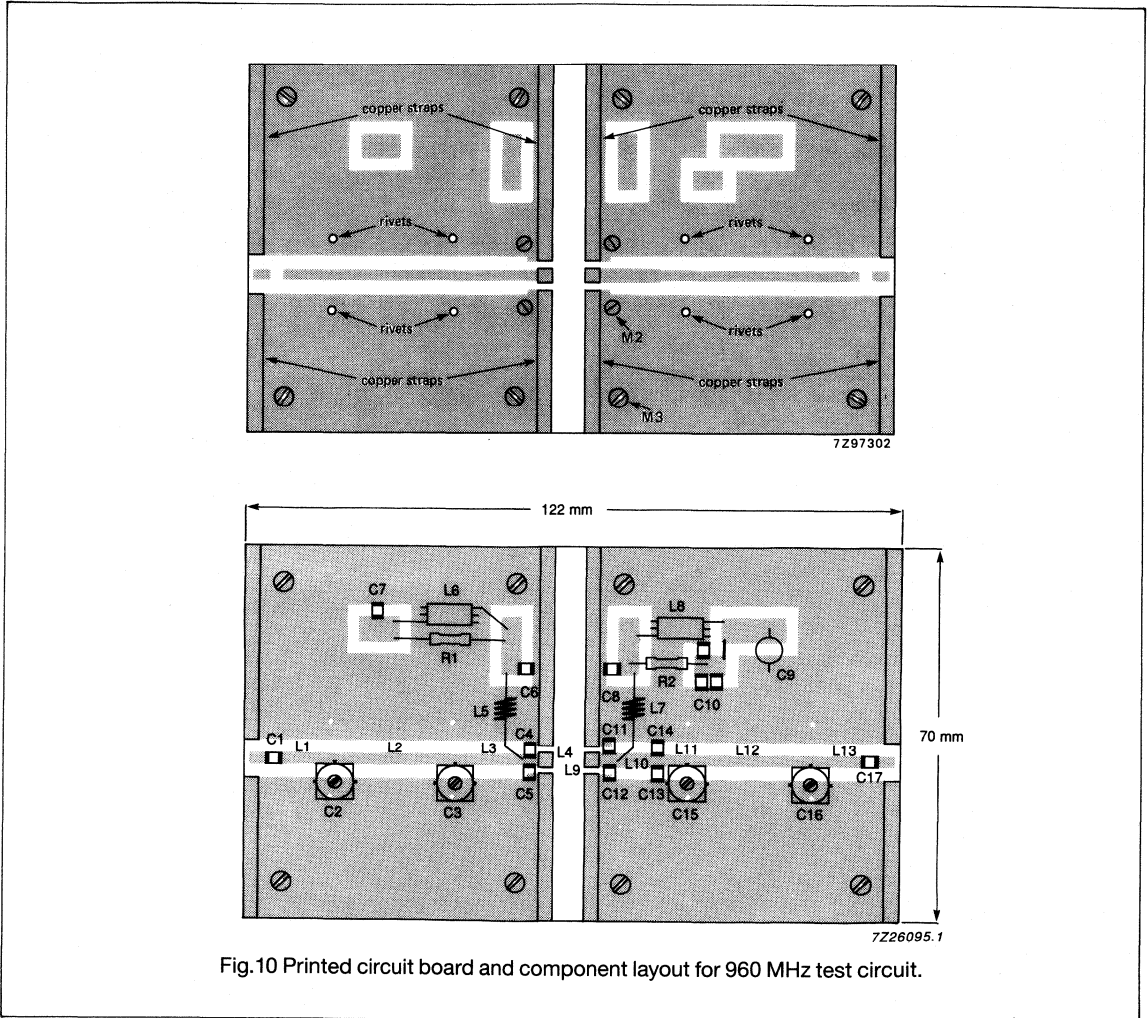


Fig. 10 Printed circuit board and component layout for 960 MHz test circuit.

The circuit and components are located on one side of the PTFE fibre-glass board, the other side being fully metallized, to serve as an earth. Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the emitters, to provide a direct contact between the component side and the ground plane.

## UHF power transistor

## BLV98CE

## APPLICATION INFORMATION (continued)

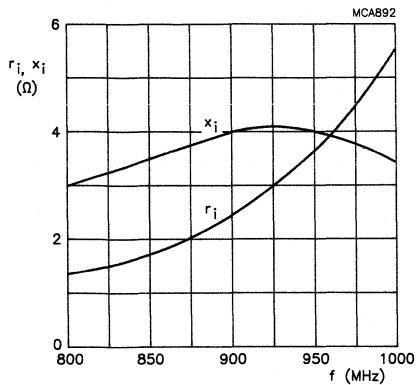


Fig. 11 Input impedance; series components;  $V_{CE} = 24$  V;  $P_L = 15$  W;  $R_{th\ mb-h} = 0.4$  K/W; typical values.

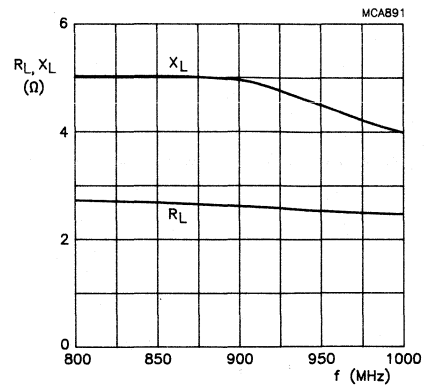


Fig. 12 Load impedance; series components;  $V_{CE} = 24$  V;  $P_L = 15$  W;  $R_{th\ mb-h} = 0.4$  K/W; typical values.

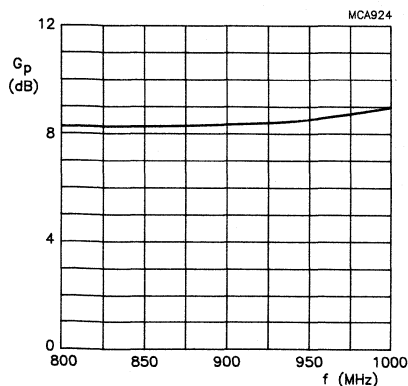


Fig. 13 Power gain; class-AB operation;  $V_{CE} = 24$  V;  $P_L = 15$  W;  $R_{th\ mb-h} = 0.4$  K/W; typical values.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use as a driver-stage in base stations in the 900 MHz communications band.

### Features:

- emitter-ballasting resistors for an optimum temperature profile
- gold metallization ensures excellent reliability

The transistor has a 4-lead stud envelope with a ceramic cap (SOT-172). All leads are isolated from the stud.

### QUICK REFERENCE DATA

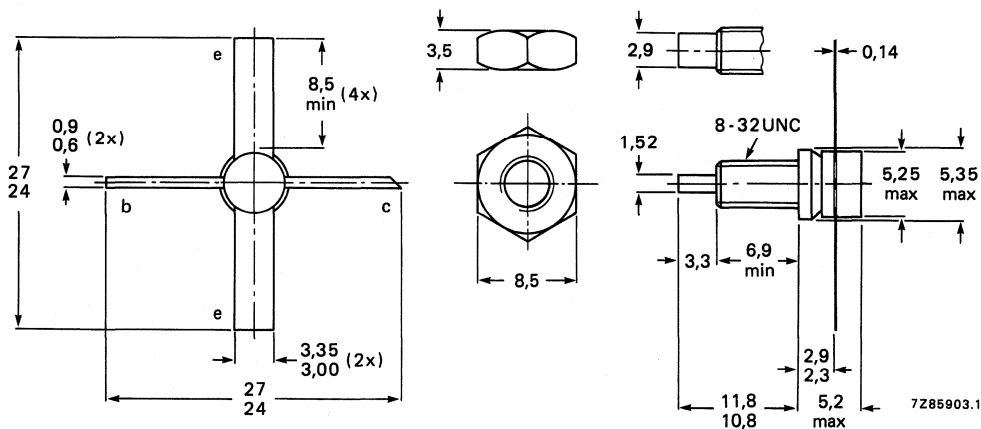
R.F. performance at  $T_h = 25^\circ\text{C}$  in a common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	Gp dB	$\eta_C$ %
narrow band; c.w.	24	900	2	> 8,0	> 55

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-172.



Torque on nut: min. 0,75 Nm (7,5 kg.cm)  
max. 0,85 Nm (8,5 kg.cm)

When locking is required an adhesive is preferred instead of a lock washer.

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.

Deburring must leave surface flat; do not chamfer or countersink either end of hole.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	50 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	27 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3,5 V
Collector current; d.c.	$I_C$	max.	0,2 A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	0,6 A
Total power dissipation at $T_{mb} = 50$ °C; $f > 1$ MHz	$P_{tot}$	max.	6 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

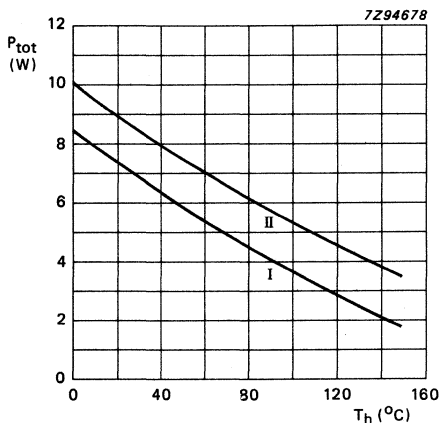


Fig. 2 Power/temperature derating curves.

- I continuous r.f. operation ( $f > 1$  MHz)
- II short-time r.f. operation during mismatch ( $f > 1$  MHz)

**THERMAL RESISTANCE**

$P = 4,5$  W;  $T_{mb} = 25$  °C

From junction to mounting base ( $f > 1$ MHz)	$R_{th\ j-mb}$	max.	20 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	max.	0,8 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-base breakdown voltage  
open emitter;  $I_C = 5\text{ mA}$

$V_{(BR)CBO}$  min. 50 V

Collector-emitter breakdown voltage  
open base;  $I_C = 10\text{ mA}$

$V_{(BR)CEO}$  min. 27 V

Emitter-base breakdown voltage  
open collector;  $I_E = 0,5\text{ mA}$

$V_{(BR)EBO}$  min. 3,5 V

Collector-emitter leakage current  
 $V_{BE} = 0$ ;  $V_{CE} = 27\text{ V}$

$I_{CES}$  max. 2 mA

Second breakdown energy at  $f = 50\text{ Hz}$   
 $L = 25\text{ mH}$ ;  $R_{BE} = 10\text{ }\Omega$

$ESBR$  min. 0,5 mJ

D.C. current gain

$I_C = 150\text{ mA}$ ;  $V_{CE} = 20\text{ V}$

$h_{FE}$  min. 25

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = i_e = 0$ ;  $V_{CB} = 24\text{ V}$

$C_C$  typ. 3 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 0$ ;  $V_{CE} = 24\text{ V}$

$C_{re}$  typ. 1,3 pF

Collector-stud capacitance

$C_{Cs}$  typ. 0,5 pF

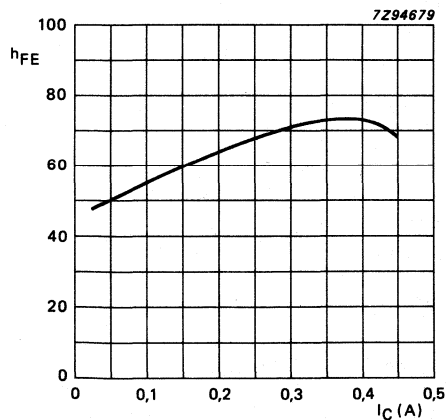


Fig. 3  $V_{CE} = 20\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$ ;  
typical values.

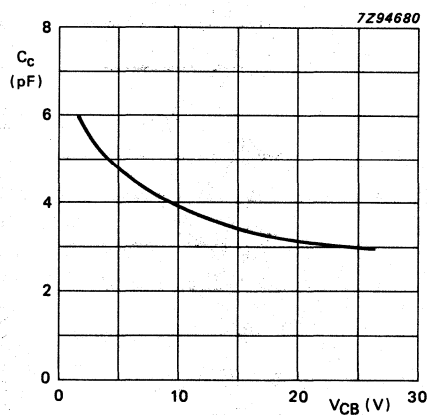


Fig. 4  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ;  
typical values.

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class-B)  
 $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0,8 \text{ K/W}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
narrow band; c.w.	24	900	2	min. 8,0 typ. 9,3	min. 55 typ. 63

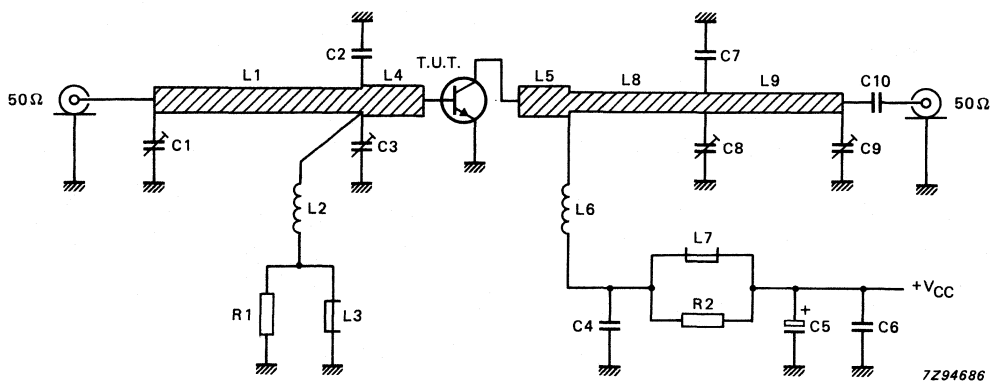


Fig. 5 class-B test circuit at  $f = 900 \text{ MHz}$ .

## List of components

C1 = C3 = C8 = C9	1,4 – 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)
C2	4,7 pF multilayer ceramic chip capacitor*
C4 = C6 = C10	220 pF multilayer ceramic chip capacitor
C5	1 $\mu\text{F}$ (63 V) electrolytic capacitor
C7	2,2 pF multilayer ceramic chip capacitor*
L1	50 $\Omega$ stripline (48 mm x 2,4 mm)
L2	60 nH; 7 turns closely wound enamelled Cu-wire (0,4 mm); int. dia. 2 mm; leads 2 x 5 mm
L3 = L7	Ferroxcube wide-band h.f. choke; grade 3B; (cat. no. 4312 020 36642)
L4 = L5	35 $\Omega$ stripline (14 mm x 4,0 mm)
L6	120 nH; 6 turns Cu-wire (1,0 mm); int. dia. 6 mm; length 10 mm leads 2 x 5 mm
L8	50 $\Omega$ stripline (31 mm x 2,4 mm)
L9	50 $\Omega$ stripline (29 mm x 2,4 mm)
R1 = R2	10 $\Omega \pm 5\%$ (0,4 W) metal film resistor

The striplines are on a Cu-clad printed-circuit board with a PTFE fibre-glass dielectric ( $\epsilon_r = 2,2$ ); thickness 1/32 inch.

\* American Technical Ceramics capacitor type 100A or capacitor of the same quality.



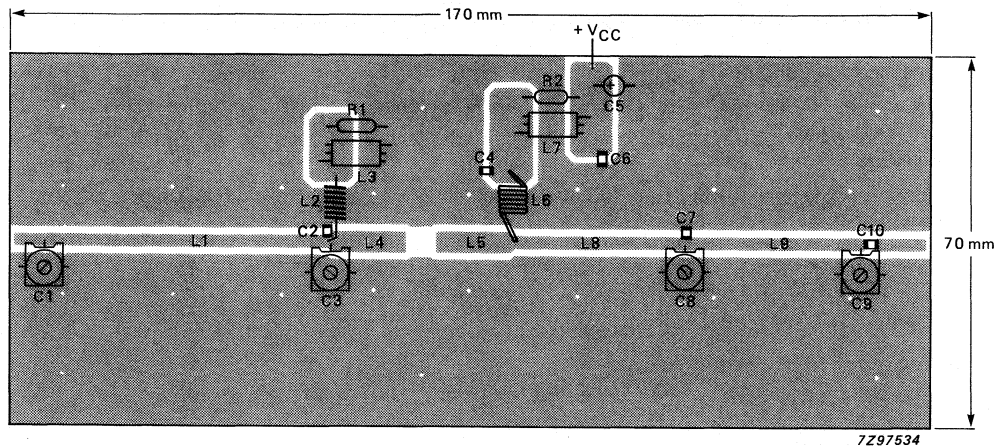
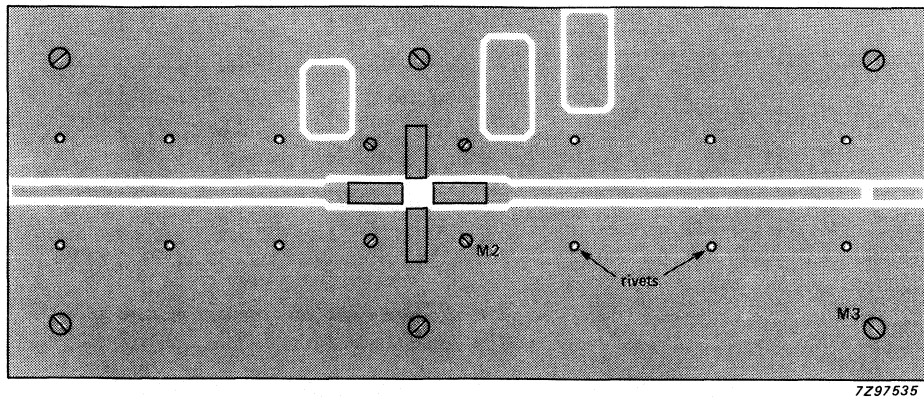


Fig. 6 Printed-circuit board and component layout for 900 MHz class-B test circuit.

**Note:**

The circuit and the components are on one side of the PTFE fibre-glass board; the other side is unetched copper serving as a ground plane. Earth connections are made by hollow rivets and also by fixing screws and copper straps under the emitters to provide a direct contact between the copper on the component side and the ground plane.

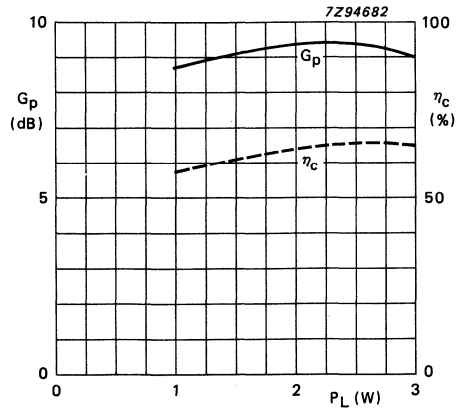
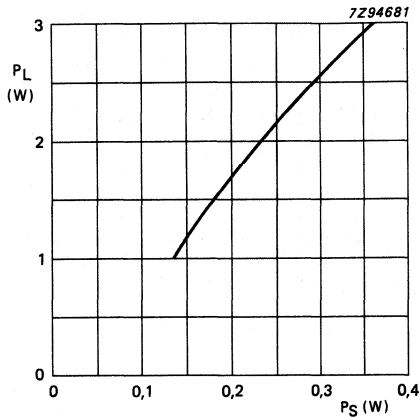


Fig. 7 Load power versus source power.

Fig. 8 Power gain and efficiency versus load power.

Conditions for Figs 7 and 8:

$V_{CE} = 24 \text{ V}$ ;  $f = 900 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\ mb-h} = 0,8 \text{ K/W}$ ; class-B operation; typical values.

**RUGGEDNESS**

The device is capable of withstanding a full load mismatch ( $VSWR = 50$ ) through all phases, at rated load power and supply voltage ( $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th\ mb-h} = 0,8 \text{ K/W}$ ).

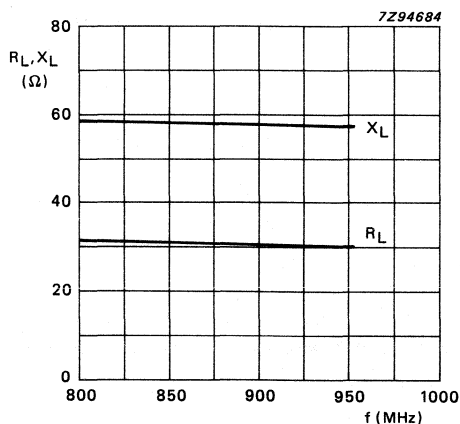
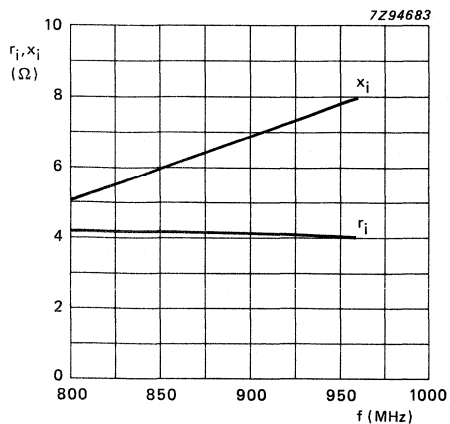


Fig. 9 Input impedance (series components).

Fig. 10 Load impedance (series components).

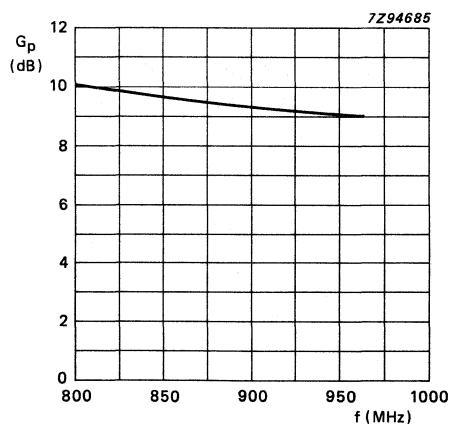


Fig. 11 Power gain versus frequency.

Conditions for Figs 9, 10 and 11:

$V_{CE} = 24$  V;  $P_L = 2$  W;  $f = 800 - 960$  MHz;  $R_{th\ mb-h} = 0,8$  K/W;  $T_h = 25$  °C; class-B operation; typical values.



## Philips Components

Data sheet	
status	Product specification
date of issue	October 1990

# BLV100

## UHF power transistor

### FEATURES

- Internal input matching to achieve high power gain
- Ballasting resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability

### DESCRIPTION

NPN silicon planar epitaxial transistor in a SOT171 envelope, intended for common emitter, class-AB operation in radio transmitters for the 960 MHz communications band. The transistor has a 6-lead flange envelope, with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

RF performance up to  $T_h = 25\text{ }^\circ\text{C}$  in a common emitter class-AB circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
c.w. class-AB	960	24	8	> 8	> 50

### MECHANICAL DATA

SOT171 - see Fig.1

### WARNING

#### Product and environmental safety - toxic materials

**This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions.**

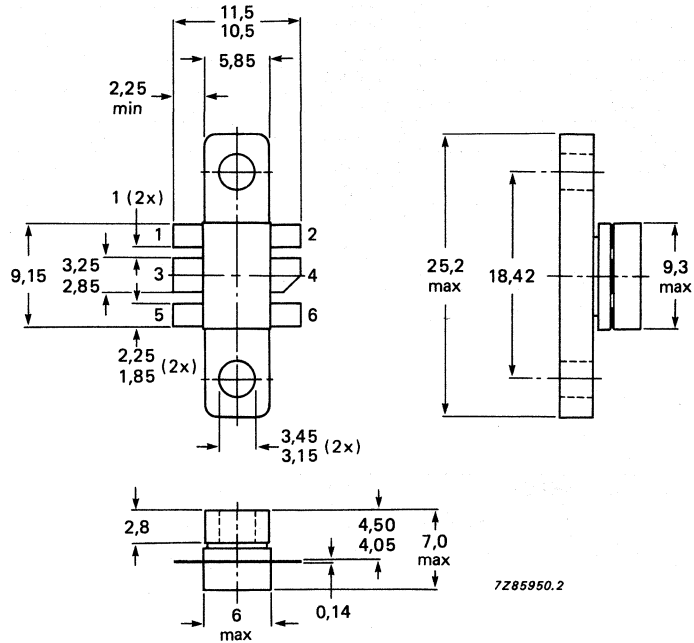
**After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.**

**UHF power transistor**

**BLV100**

**MECHANICAL DATA**

Dimensions in mm



Torque on screw: min. 0.6 Nm (6 kg.cm)  
max. 0.75 Nm (7.5 kg.cm)

Recommended screw: cheese-head 4-40 UNC/2A

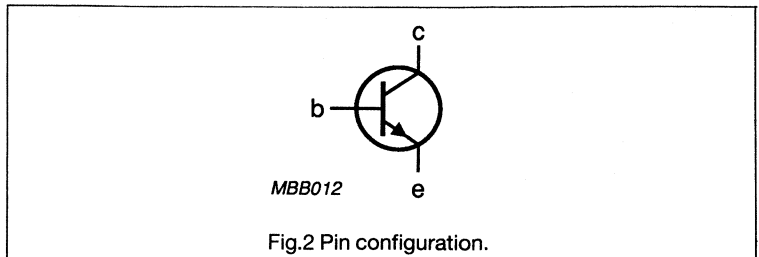
Heatsink compound must be applied sparingly and evenly distributed.

Fig.1 SOT171.

**PINNING**

PIN	DESCRIPTION
1	emitter
2	emitter
3	base
4	collector
5	emitter
6	emitter

**PIN CONFIGURATION**



# UHF power transistor

# BLV100

## LIMITING VALUES

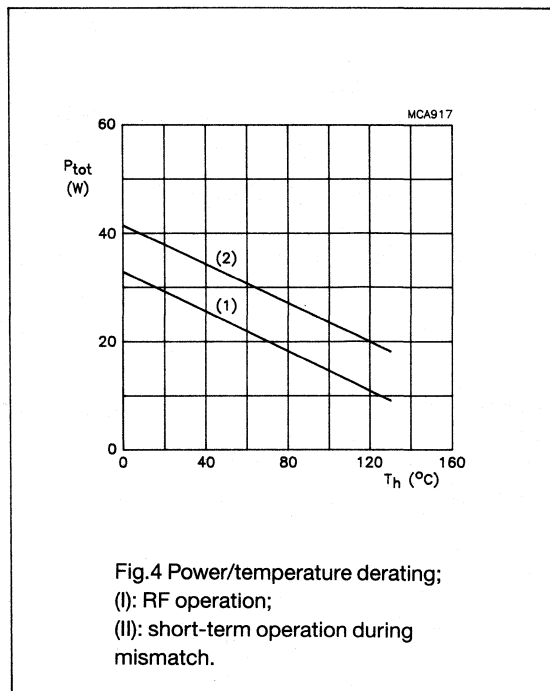
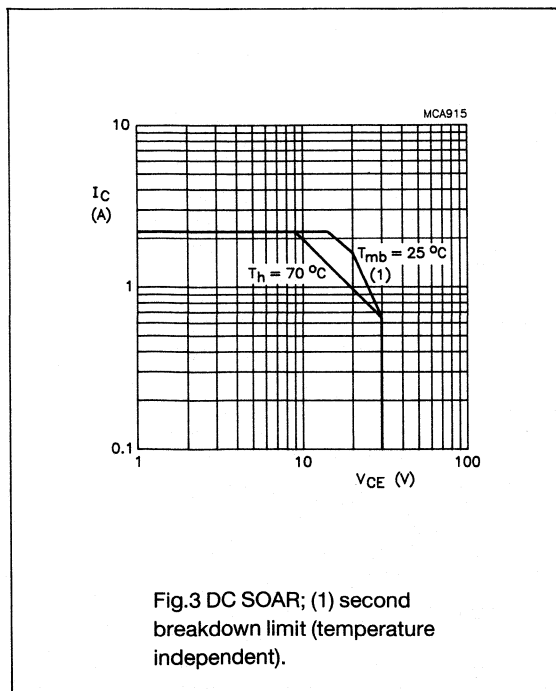
Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CESM}$	collector emitter voltage	peak value $V_{BE} = 0$	-	50	V
$V_{CEO}$	collector emitter voltage	open base	-	30	V
$V_{EBO}$	emitter base voltage	open collector	-	4	V
$I_C$	collector current	DC or average	-	2.25	A
$I_{CM}$	collector current	peak value $f > 1$ MHz	-	3.5	A
$P_{tot}$	total power dissipation	$f > 1$ MHz $T_{mb} = 25\text{ }^\circ\text{C}$	-	31	W
$T_{stg}$	storage temperature range		-65	150	$^\circ\text{C}$
$T_j$	operating junction temperature		-	200	$^\circ\text{C}$

## THERMAL RESISTANCE

Dissipation = 31 W,  $T_{mb} = 25\text{ }^\circ\text{C}$

SYMBOL	PARAMETER	MAX.	UNIT
$R_{th\ j-mb}$	from junction to mounting base (RF)	5.6	K/W
$R_{th\ mb-h}$	from mounting base to heatsink	0.4	K/W



## UHF power transistor

BLV100

## CHARACTERISTICS

at  $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)CES}$	collector-emitter breakdown voltage	$V_{BE} = 0$ $I_C = 8\text{ mA}$	50	–	–	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base $I_C = 60\text{ mA}$	30	–	–	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector $I_E = 4\text{ mA}$	4	–	–	V
$I_{CES}$	collector leakage current	$V_{BE} = 0$ $V_{CE} = 30\text{ V}$	–	–	2	mA
$h_{FE}$	DC current gain	$I_C = 0.6\text{ A}$ $V_{CE} = 25\text{ V}$	20	75	–	
$C_C$	collector capacitance	$f = 1\text{ MHz}$ $I_E = I_e = 0$ $V_{CB} = 25\text{ V}$	–	13.5	–	pF
$C_{re}$	feedback capacitance	$f = 1\text{ MHz}$ $I_C = 40\text{ mA}$ $V_{CE} = 25\text{ V}$	–	8.4	–	pF
$C_{cf}$	collector-flange capacitance		–	2	–	pF

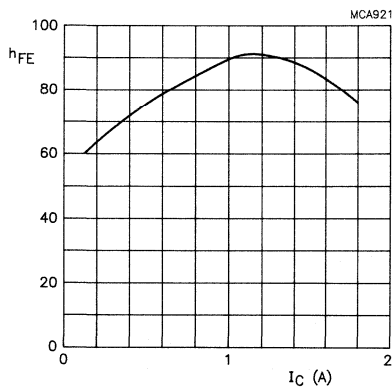


Fig. 5 DC current gain as a function of collector current;  $V_{CE} = 25\text{ V}$ ; typical values.

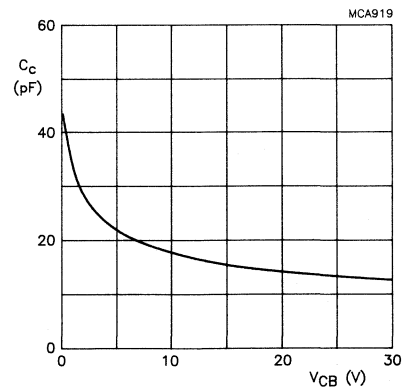


Fig. 6 Output capacitance as a function of collector-base voltage; typical values.



# UHF power transistor

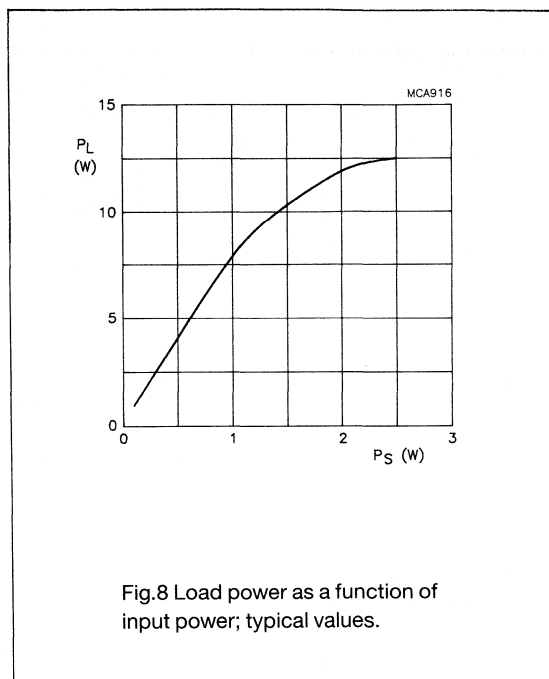
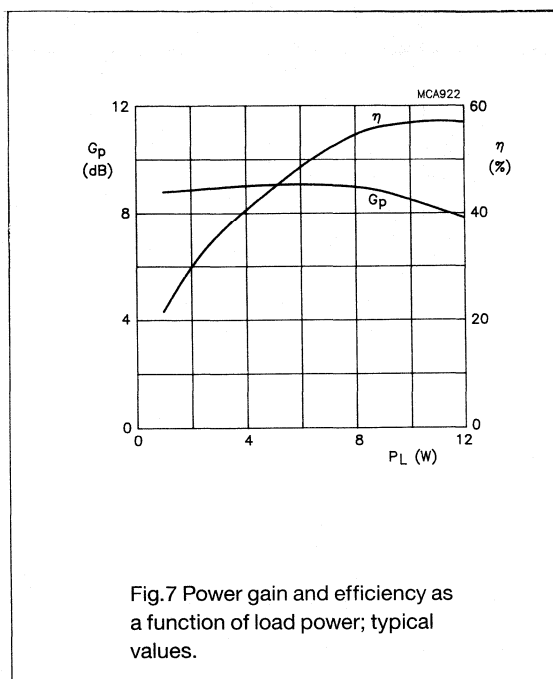
# BLV100

## APPLICATION INFORMATION

RF performance in a class-AB test circuit.

$T_h = 25\text{ }^\circ\text{C}$ ,  $R_{th\text{ mb-h}} = 0.4\text{ K/W}$  unless otherwise specified.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	I <sub>C(zs)</sub> (mA)	P <sub>L</sub> (W)	G <sub>P</sub> (dB)	$\eta_c$ (%)
c.w. class-AB	960	24	20	8	> 8 typ. 9	> 50 typ. 55



### Ruggedness in class-AB operation

The BLV100 is capable of withstanding a load mismatch corresponding to VSWR = 10 through all phases, under the following conditions:  $V_{CE} = 24\text{ V}$ ,  $f = 960\text{ MHz}$  at rated output power.

**UHF power transistor**

**BLV100**

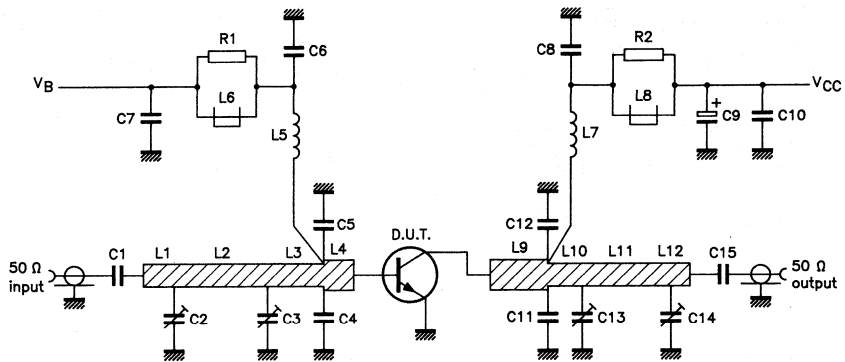


Fig.9 Test circuit BLV100 class-AB.

**UHF power transistor****BLV100****List of components (Fig. 9)**

DESIGNATION	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C6, C7, C8, C15	multilayer ceramic chip capacitor	330 pF		
C2, C3, C13, C14	film dielectric trimmer	1.4 to 5.5 pF		2222 809 09001
C4, C5	multilayer ceramic chip capacitor note 1	5.1 pF		
C9	35 V solid aluminium capacitor	2.2 $\mu$ F		2222 128 50228
C10	multilayer ceramic chip capacitor	33 x 100 nF in parallel		
C11, C12	multilayer ceramic chip capacitor note 2	6.2 pF		
L1, L12	microstrip note 3	50 $\Omega$	9.0 x 2.4 mm	
L2, L11	microstrip note 3	50 $\Omega$	23.0 x 2.4 mm	
L3	microstrip note 3	50 $\Omega$	16.0 x 2.4 mm	
L4	microstrip note 3	43 $\Omega$	3.0 x 3.0 mm	
L5	3 turns enamelled 0.8 mm copper wire		int. dia. 3 mm length 5 mm leads 2 x 5 mm	
L6, L8	grade 3B ferroxcube wide-band RF choke			4312 020 36642
L7	4 turns enamelled 0.8 mm copper wire		int. dia. 4 mm length 5 mm leads 2 x 5 mm	
L9	microstrip note 3	43 $\Omega$	14.5 x 3.0 mm	
L10	microstrip note 3	50 $\Omega$	4.5 x 2.4 mm	
R1, R2	0.4 W metal film resistor	10 $\Omega$		2322 151 71009

**Notes**

1. ATC capacitor type 100A or capacitor of the same quality.
2. ATC capacitor type 100B or capacitor of the same quality.
3. The microstrips are on a double copper-clad PCB with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness 1/32 inch.

## UHF power transistor

BLV100

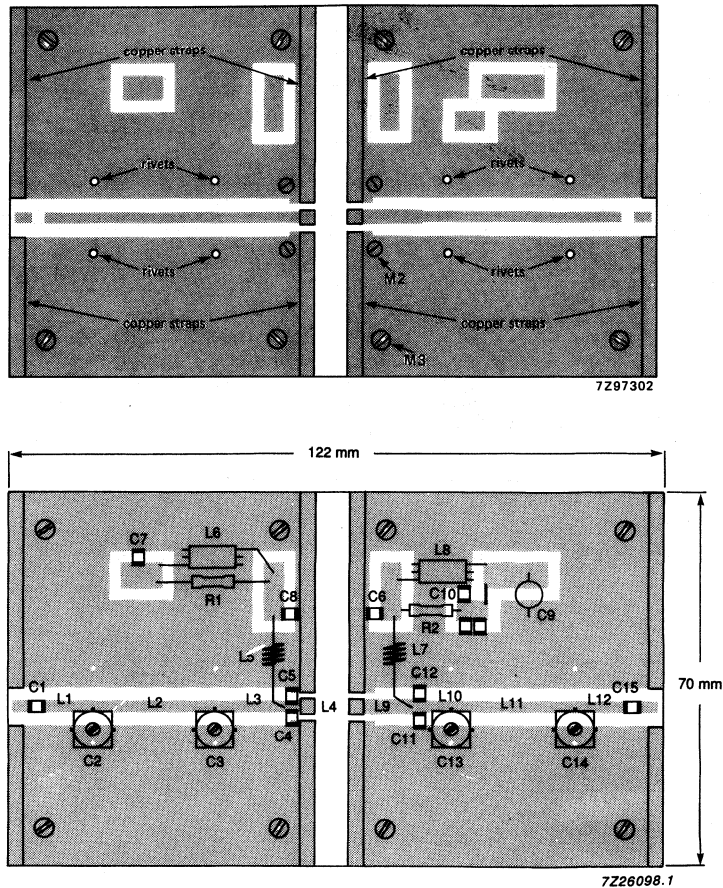


Fig.10 Printed-circuit board and component layout for 960 MHz test circuit.

The circuit and components are located on one side of the PTFE fibre-glass board, the other side being fully metallized, to serve as an earth. Earth connections are made by fixing screws, hollow rivets and copper straps around the board and under the emitters, to provide a direct contact between the component side and the ground plane.

## UHF power transistor

BLV100

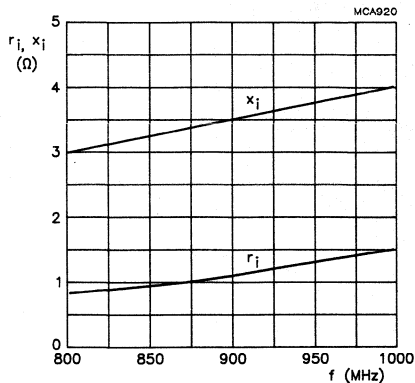


Fig.11 Input impedance; series components;  $V_{CE} = 24$  V,  $I_{C(ZS)} = 20$  mA,  $P_L = 8$  W,  $f = 960$  MHz; typical values.

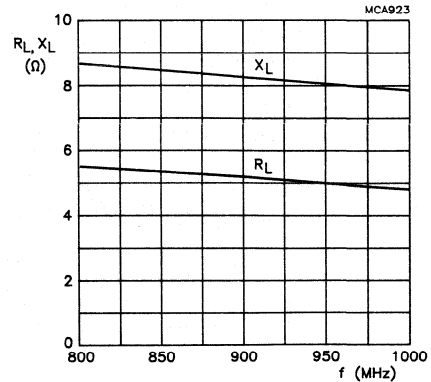


Fig.12 Load impedance; series components;  $V_{CE} = 24$  V,  $I_{C(ZS)} = 20$  mA,  $P_L = 8$  W,  $f = 960$  MHz; typical values.

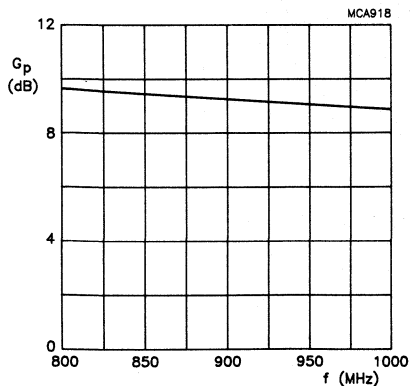


Fig.13 Power gain; class-AB operation;  $V_{CE} = 24$  V,  $I_{C(ZS)} = 20$  mA,  $P_L = 8$  W,  $f = 960$  MHz; typical values.



Data sheet	
status	Product specification
date of issue	October 1990

# BLV101A/BLV101B

## UHF power transistors

### FEATURES

- High input and output impedances promote easy matching
- Implanted ballast resistors for optimum temperature profile
- Gold metallization ensures excellent reliability

### DESCRIPTION

NPN silicon planar epitaxial transistors, intended for common emitter, class-AB operation in base station transmitters in the frequency range 850 – 960 MHz. Both transistors have an SOT273 6-lead flange envelope, with a ceramic cap. All leads are isolated from the flange.

### WARNING

#### Product and environmental safety - toxic materials

**This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions.**

**After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.**

### QUICK REFERENCE DATA

RF performance at  $T_H = 25\text{ }^\circ\text{C}$  in a common emitter test circuit. Mode of operation: c.w. class-AB.

TYPE	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
BLV101A	900	26	50	> 8.5	> 48
	960	26	50	typ. 9.8	typ. 45
BLV101B	960	26	50	> 7.5	> 46
	900	26	50	typ. 8.1	typ. 57

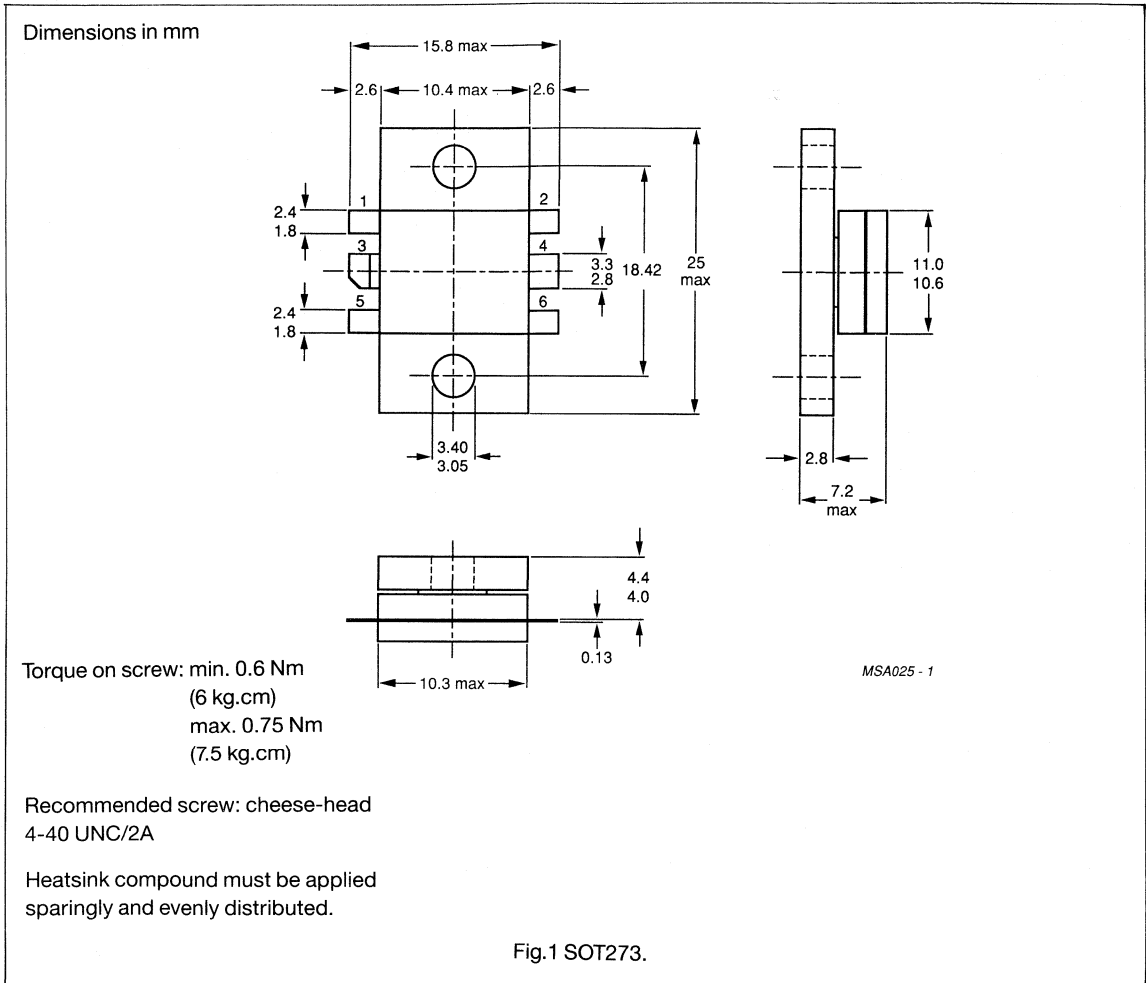
### MECHANICAL DATA

SOT273 - see Fig.1.

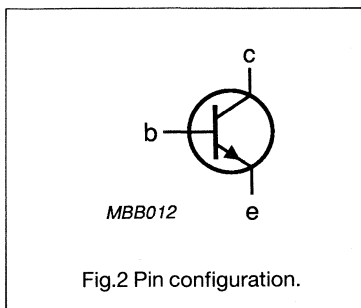
**UHF power transistors**

**BLV101A/BLV101B**

**MECHANICAL DATA**



**PIN CONFIGURATION**



**PINNING**

PIN	DESCRIPTION
1	emitter
2	emitter
3	collector
4	base
5	emitter
6	emitter



# UHF power transistors

# BLV101A/BLV101B

## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134). The following values apply to both transistors.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector base voltage	open emitter	–	50	V
$V_{CEO}$	collector emitter voltage	open base	–	27	V
$V_{EBO}$	emitter base voltage	open collector	–	3.5	V
$I_C$	collector current	DC or average	–	10	A
$P_{tot}$	total power dissipation	$f > 1$ MHz $T_{mb} = 25$ °C	–	100	W
$T_{stg}$	storage temperature range		–65	150	°C
$T_j$	operating junction temperature		–	200	°C

## THERMAL RESISTANCE

The following values apply to both transistors.

SYMBOL	PARAMETER	MAX.	UNIT
$R_{th\ j-mb}$	from junction to mounting base (RF)	1.75	K/W
$R_{th\ mb-h}$	from mounting base to heatsink	0.3	K/W

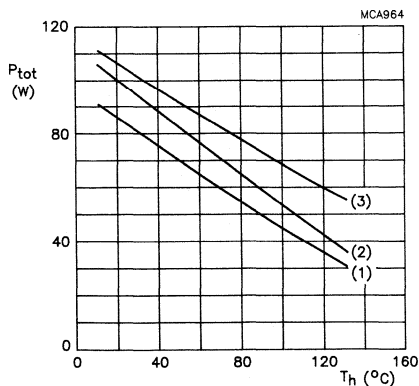


Fig.3 Power/temperature derating;  
 (1): DC operation;  
 (2): continuous RF operation ( $f > 1$  MHz);  
 (3): short time operation during mismatch ( $f > 1$  MHz).

## UHF power transistors

## BLV101A/BLV101B

## CHARACTERISTICS

at  $T_j = 25\text{ }^\circ\text{C}$  unless otherwise stated. The following values apply to both transistors.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter $I_C = 75\text{ mA}$	50	–	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base $I_C = 150\text{ mA}$	27	–	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector $I_E = 15\text{ mA}$	3.5	–	V
$I_{CES}$	collector leakage current	$V_{BE} = 0$ $V_{CE} = 27\text{ V}$	–	15	mA
$h_{FE}$	DC current gain	$I_C = 3\text{ A}$ $V_{CE} = 20\text{ V}$	15	–	
$C_{ob}$	output capacitance (note 1)	$f = 1\text{ MHz}$ $I_E = I_e = 0$ $V_{CB} = 26\text{ V}$	–	75	pF

## Notes

- The value of  $C_{ob}$  is that of the die only; it is not measurable, because of the internal matching network.

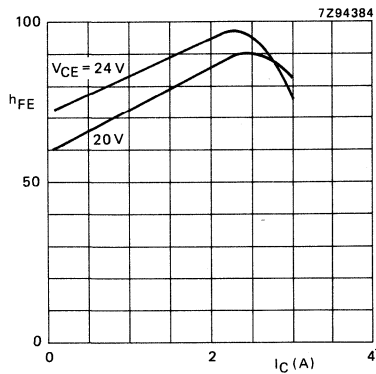


Fig.4 DC current gain as a function of collector current.

## UHF power transistors

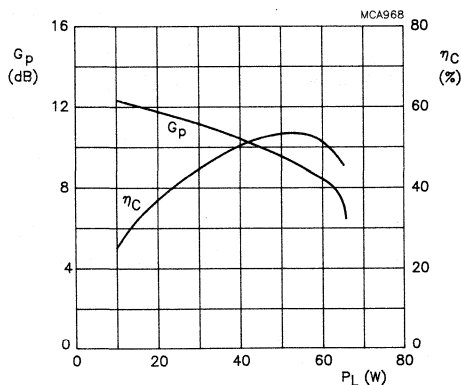
## BLV101A/BLV101B

## APPLICATION INFORMATION

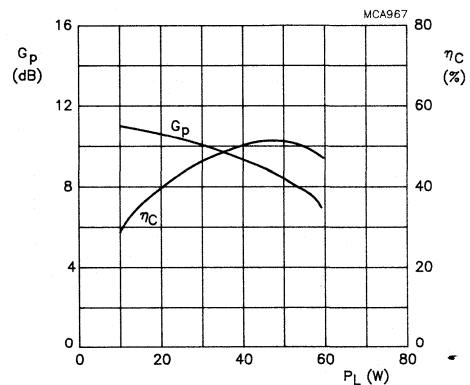
RF performance in a common emitter test circuit.

$T_h = 25\text{ }^\circ\text{C}$ ,  $R_{th\text{ mb-h}} = 0.3\text{ K/W}$ . Mode of operation: c.w class-AB.

TYPE	f (MHz)	V <sub>CE</sub> (V)	I <sub>C(zs)</sub> (mA)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
BLV101A	900	26	200	50	> 8.5 typ. 9.5	> 48 typ. 53
	900	26	200	60	typ. 8.3	typ. 50
	960	26	200	50	typ. 9.8	typ. 45
BLV101B	960	26	200	50	> 7.5 typ. 8.4	> 46 typ. 51
	900	26	200	50	typ. 8.1	typ. 57



(a) BLV101A; f = 900 MHz.



(b) BLV101B; f = 960 MHz.

Fig.5 Power gain and efficiency as a function of load power; typical values.

## Ruggedness in class-AB operation

The BLV101A and BLV101B are capable of withstanding a load mismatch corresponding to  $V_{SWR} = 5$  through all phases, under the following conditions:

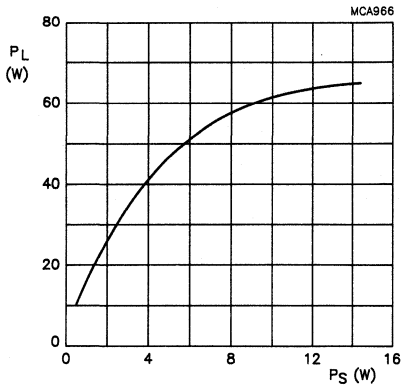
$V_{CE} = 26\text{ V}$ ; f = 900 MHz (BLV101A),

f = 960 MHz (BLV101B) at

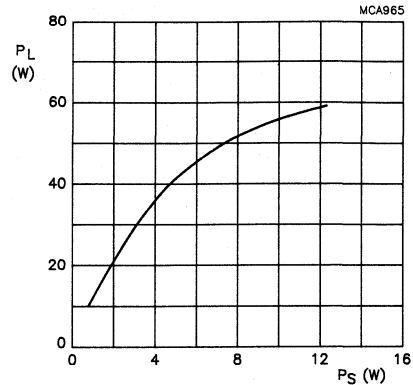
$P_L = 50\text{ W}$ .

# UHF power transistors

# BLV101A/BLV101B



(a) BLV101A; f = 900 MHz.



(b) BLV101B; f = 960 MHz.

Fig.6 Load power as a function of input power; typical values.

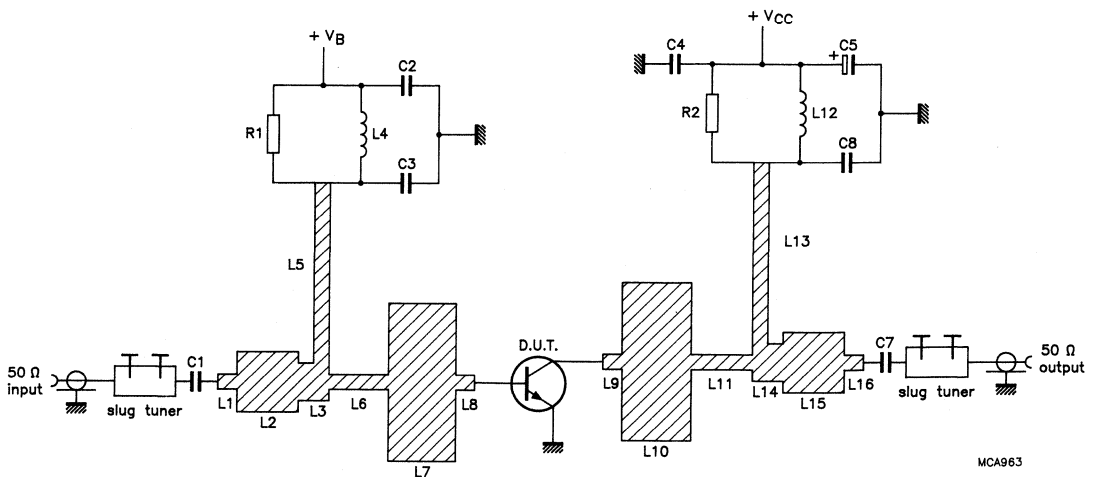


Fig.7 Test circuit BLV101A/101B class-AB.

**UHF power transistors****BLV101A/BLV101B****List of components** (Fig. 7)

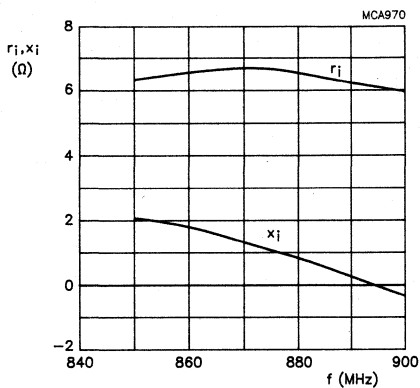
DESIGNATION	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C7	500 V multilayer ceramic chip capacitor note 1	100 pF		
C2, C4	50 V multilayer ceramic chip capacitor note 1	100 nF		
C3, C6	multilayer ceramic chip capacitor note 1	2 x 20 pF in parallel		
C5	63 V electrolytic capacitor	10 $\mu$ F		2222 030 28109
R1	0.4 W metal film resistor	10 $\Omega$		2322 151 71009
R2	0.4 W metal film resistor	5.11 $\Omega$		2322 151 75118
L1, L16	microstripline note 2		width 2.4 mm length 3 mm	
L2, L15	microstripline note 2		width 8.7 mm length 17.3 mm	
L3, L14	microstripline note 2		width 5 mm length 7.8 mm	
L4	micro choke	2.2 $\mu$ H		4322 057 02281
L5, L13	microstripline note 2		width 2.4 mm length 61 mm	
L6, L11	microstripline note 2		width 2.2 mm length 13.5 mm	
L7, L10	microstripline note 2		width 37.9 mm length 19.8 mm	
L8, L9	microstripline note 2		width 3.2 mm length 5 mm	
L12	4 turns 1 mm close wound enamelled copper wire	110 nH	int.dia. 6 mm	

**Notes**

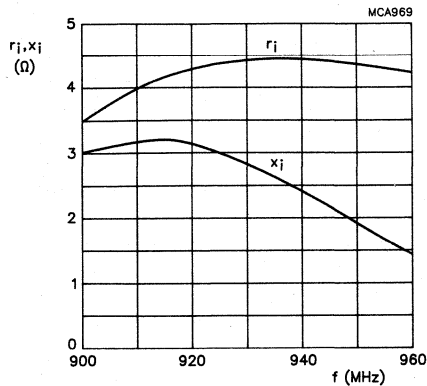
1. ATC capacitor type 100B or capacitor of the same quality.
2. L1, L2, L3, L5, L6 - L13, and L14 - L16 are microstriplines on a double copper-clad PCB, with a glass microfibre reinforced PTFE dielectric ( $\epsilon_r = 2.2$ ); thickness 1/16 inch; thickness of copper sheet 2 x 35  $\mu$ m.

UHF power transistors

BLV101A/BLV101B

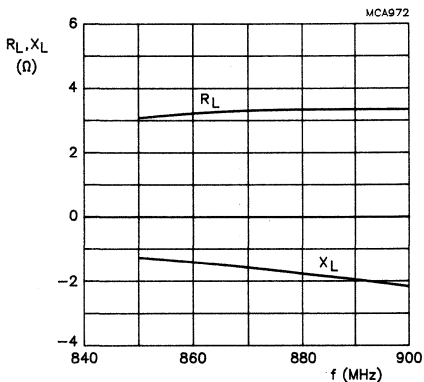


(a) BLV101A.

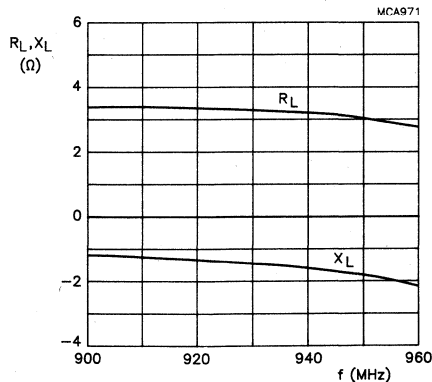


(b) BLV101B.

Fig.8 Input impedance; series components;  $V_{CE} = 26$  V;  $P_L = 50$  W,  $I_{C(ZS)} = 200$  mA; typical values.



(a) BLV101A.

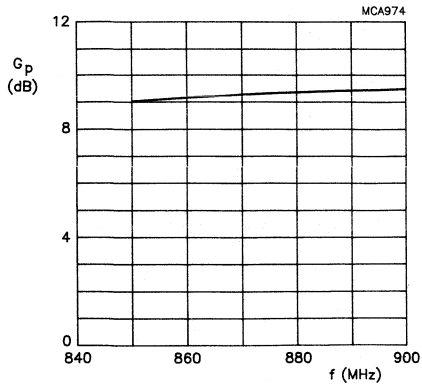


(b) BLV101B.

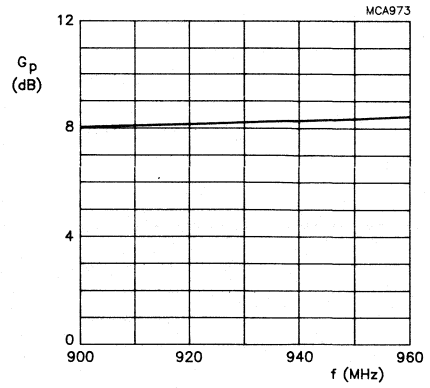
Fig.9 Load impedance; series components;  $V_{CE} = 26$  V;  $P_L = 50$  W,  $I_{C(ZS)} = 200$  mA; typical values.

## UHF power transistors

## BLV101A/BLV101B



(a) BLV101A.



(b) BLV101B.

Fig.10 Power gain; class-AB operation;  $V_{CE} = 26$  V;  $P_L = 50$  W,  $I_{C(ZS)} = 200$  mA; typical values.





## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B or C operated mobile transmitters with a nominal supply voltage of 13,5 V. Because of the high gain and excellent power handling capability, the transistor is especially suited for design of wide-band and semi-wide-band v.h.f. amplifiers. Together with a BFO42 driver stage, the chain can deliver 15 W with a maximum drive power of 120 mW at 175 MHz. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

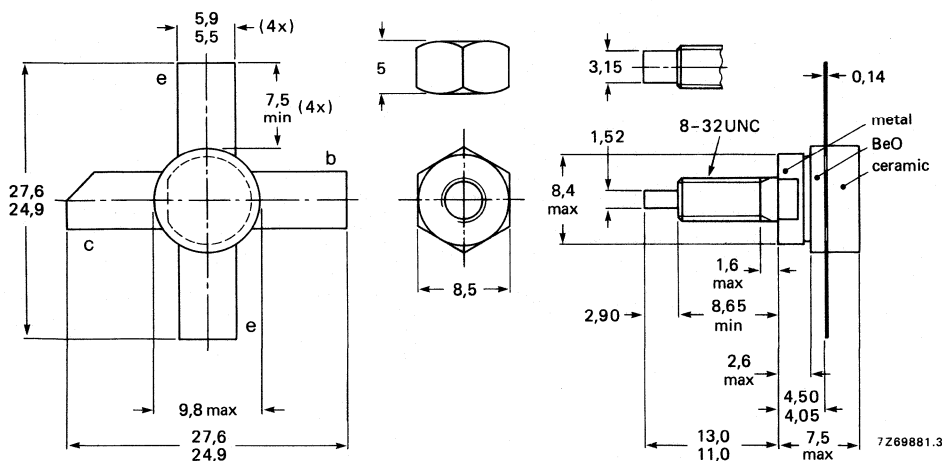
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w. class-B	13,5	175	15	> 10	> 60	1,3 + j0,68	180 - j54
c.w. class-B	12,5	175	15	typ. 10,5	typ. 67	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value

$V_{CESM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_{C(AV)}$  max. 2,75 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 8 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 53 W

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

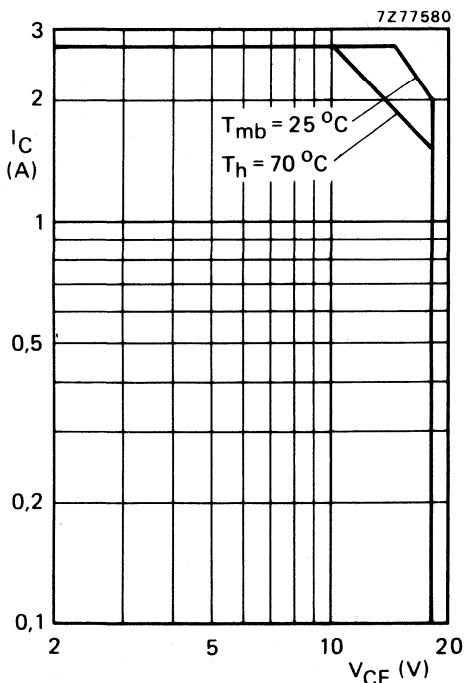


Fig. 2 D.C. SOAR.

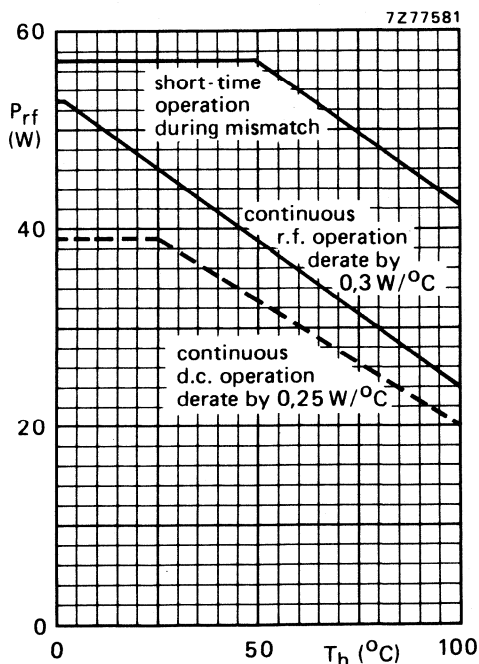


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f \geq 1$  MHz.

**THERMAL RESISTANCE** (dissipation = 15 W;  $T_{mb} = 77$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th\ j-mb(dc)}$  = 3,7 K/W

From junction to mounting base (r.f. dissipation)

$R_{th\ j-mb(rf)}$  = 3,05 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,45 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 15\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 100\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 5\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 5\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 4\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $E_{SBR} > 4\text{ mJ}$ 

D.C. current gain\*

 $I_C = 1,75\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 80

Collector-emitter saturation voltage\*

 $I_C = 5\text{ A}; I_B = 1\text{ A}$  $V_{CEsat}$  typ. 1,5 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 1,75\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 900 MHz $-I_E = 5\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 825 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 13,5\text{ V}$  $C_C$  typ. 43 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 13,5\text{ V}$  $C_{re}$  typ. 27 pF

Collector-stud capacitance

 $C_{cs}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

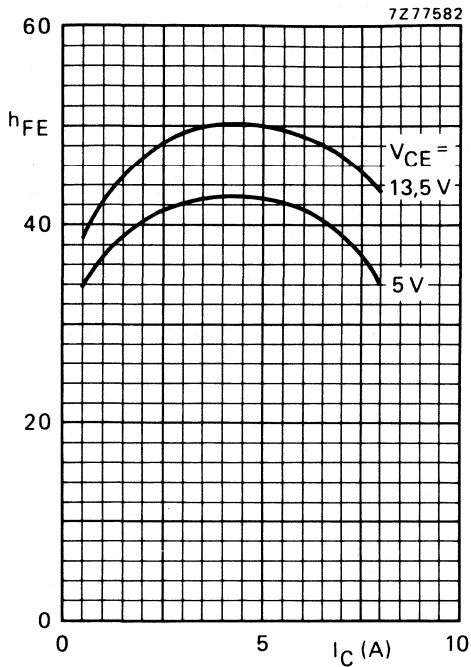


Fig. 4 Typical values;  $T_j = 25$  °C.

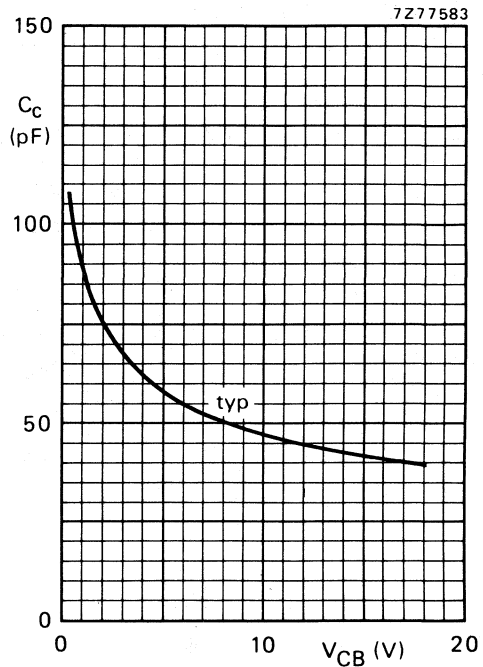


Fig. 5  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.

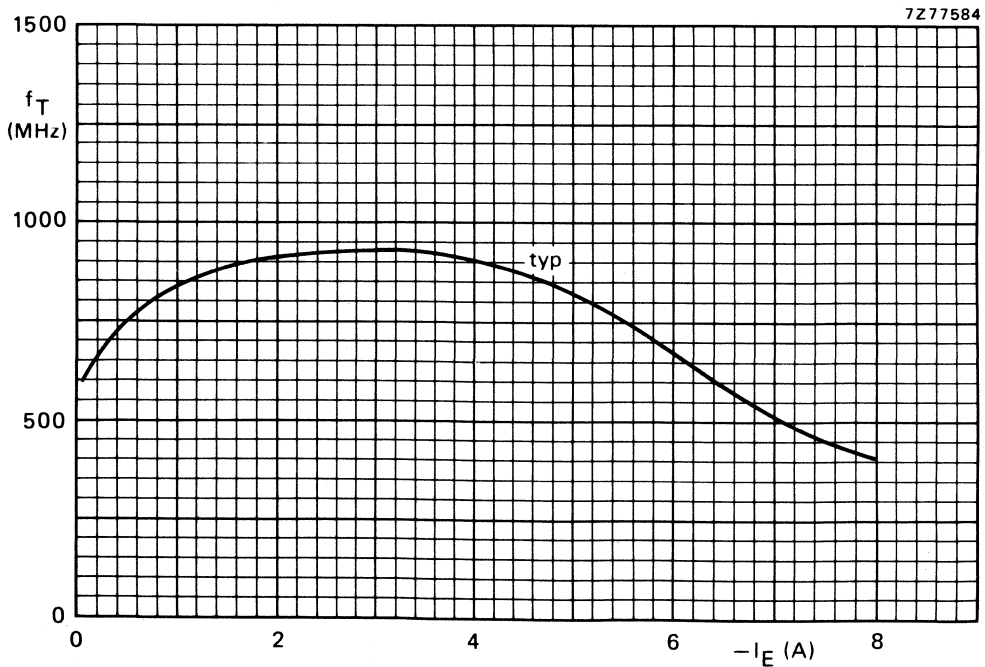


Fig. 6  $V_{CB} = 13.5$  V;  $f = 100$  MHz;  $T_j = 25$  °C.

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	13,5	15	< 1,5	> 10	< 1,85	> 60	1,3 + j0,68	180 - j54
175	12,5	15	typ. 1,34	typ. 10,5	typ. 1,8	typ. 67	-	-

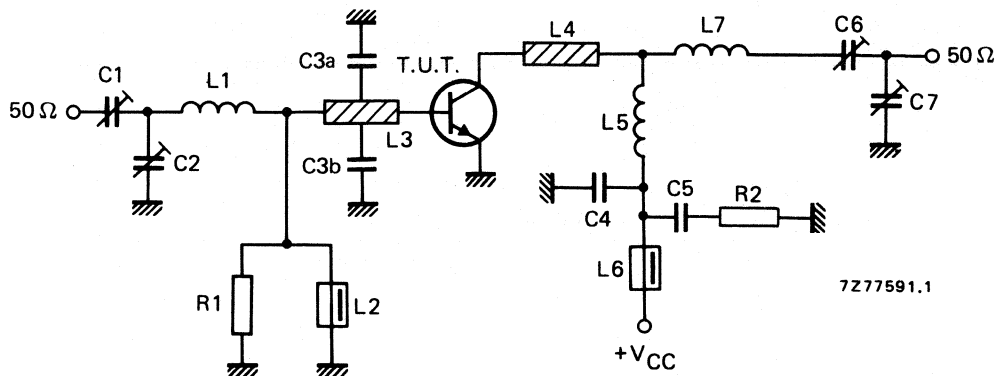


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = C7 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 1 nF ceramic capacitor

C5 = 100 nF polyester capacitor

L1 = 1/2 turn Cu wire (1,6 mm); int. dia. 6,0 mm; leads 2 x 5 mm

L2 = L6 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L4 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L5 = 4 1/2 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 6,0 mm; leads 2 x 5 mm

L7 = 2 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 6,0 mm; leads 2 x 5 mm

L3 and L4 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit are shown in Fig. 8.

## APPLICATION INFORMATION (continued)

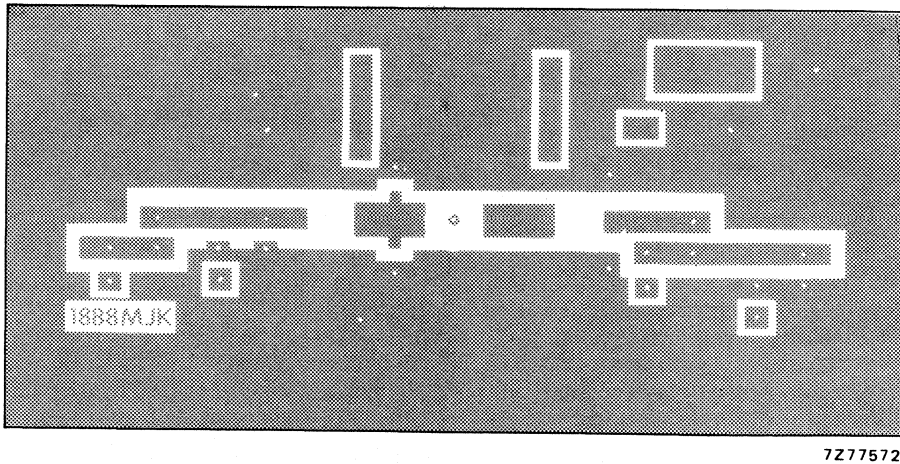
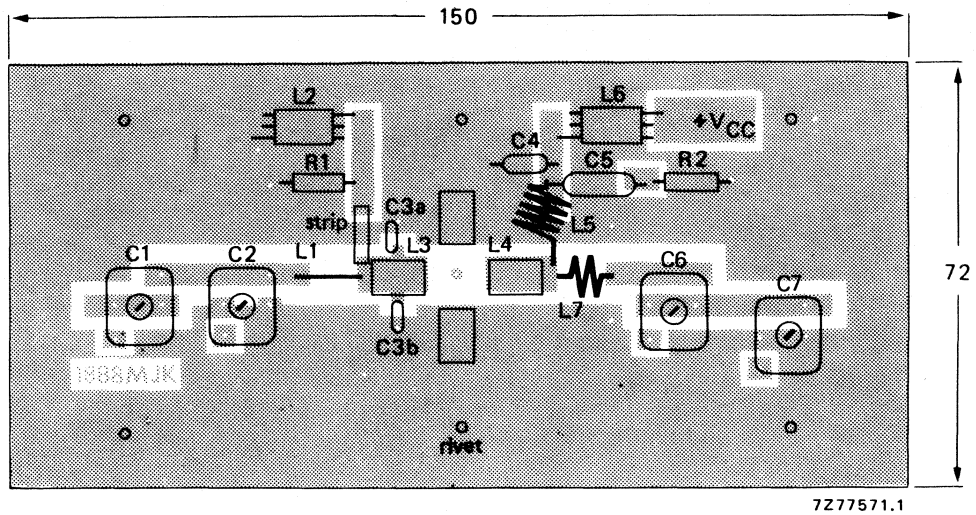


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

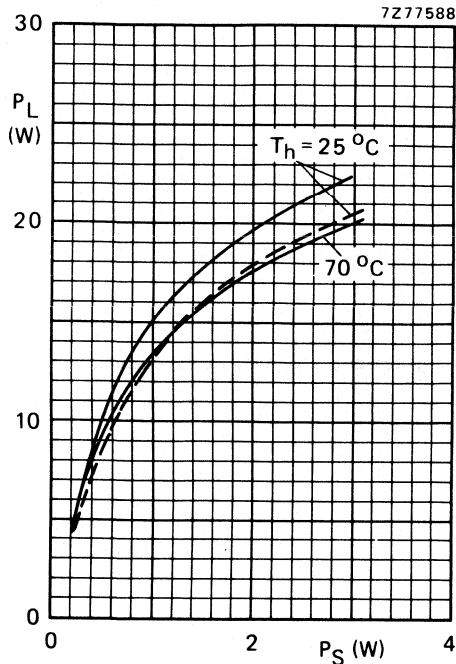


Fig. 9 Typical values;  $f = 175$  MHz;  
 —  $V_{CE} = 13,5$  V; - - -  $V_{CE} = 12,5$  V.

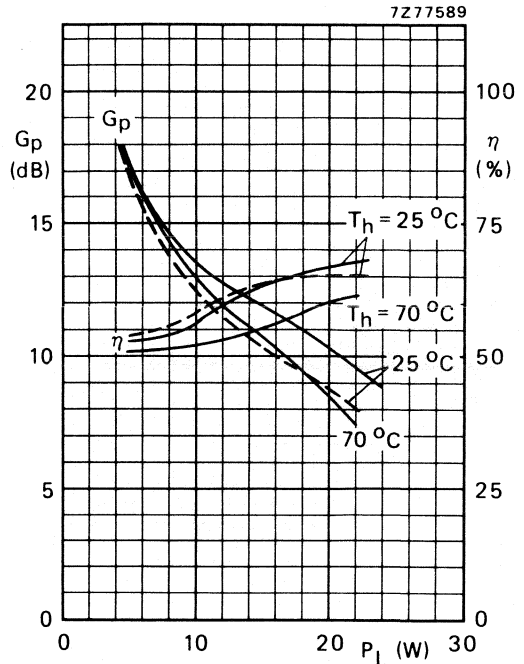


Fig. 10 Typical values;  $f = 175$  MHz;  
 —  $V_{CE} = 13,5$  V; - - -  $V_{CE} = 12,5$  V.

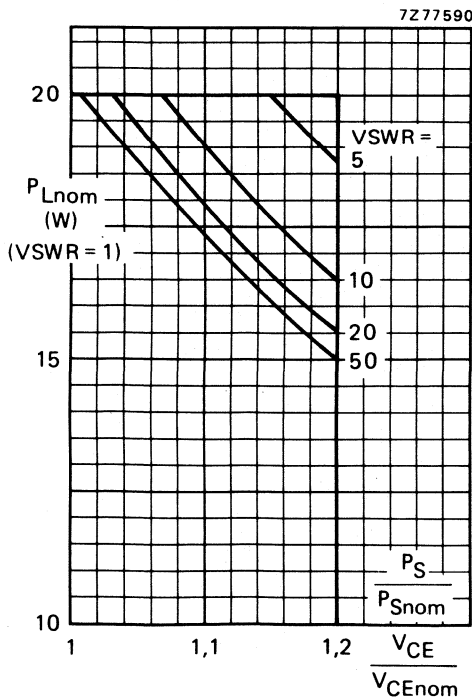


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175$  MHz;  $T_h = 70$  °C;  $R_{th\ mb-h} = 0,45$  K/W;  $V_{CEnom} = 13,5$  V or 12,5 V;  $P_S = P_{Snom}$  at  $V_{CEnom}$  and  $VSWR = 1$ .

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ), as a function of the expected supply over-voltage ratio with  $VSWR$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 70 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

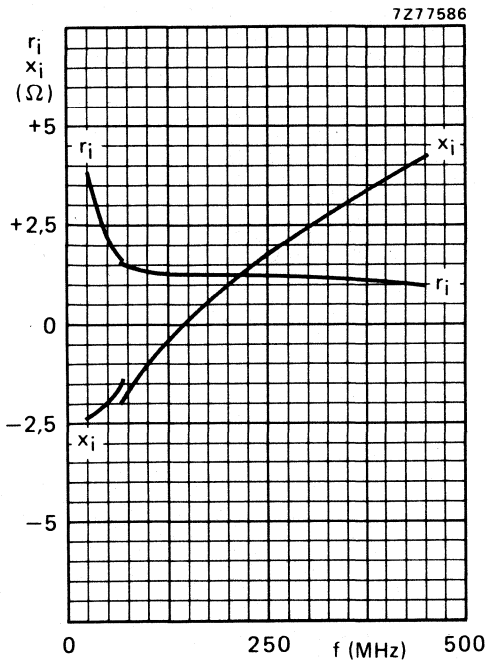


Fig. 12.

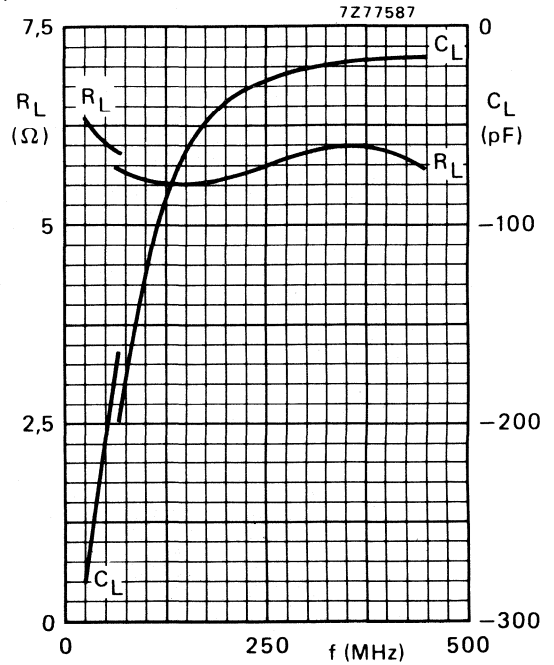
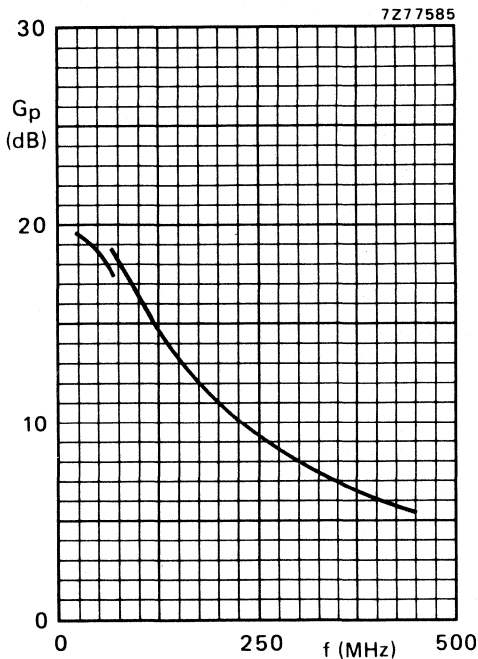


Fig. 13.



Conditions for Figs 12, 13 and 14:  
 Typical values;  $V_{CE} = 13,5\text{ V}$ ;  $P_L = 15\text{ W}$ ;  
 $T_h = 25\text{ }^\circ\text{C}$ .

Fig. 14.



Data sheet	
status	Preliminary specification
date of issue	October 1990

# BLW30

## VHF power transistor

### DESCRIPTION

NPN silicon planar epitaxial transistor in a SOT120 envelope, intended for use in large-signal power amplifiers in the VHF band. The device is designed for a supply voltage of 12.5 V. The transistor has a 4-lead capstan envelope, with a ceramic cap. All leads are isolated from the mounting base.

### QUICK REFERENCE DATA

RF performance at  $T_h = 25\text{ }^\circ\text{C}$ ,  $R_{th\text{ mb-h}} = 0.45\text{ K/W}$ .

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_c$ (%)
c.w. class-B	175	12.5	30	> 10.0 typ. 11.5	> 55 typ. 60

### MECHANICAL DATA

SOT120 - see Fig.1.

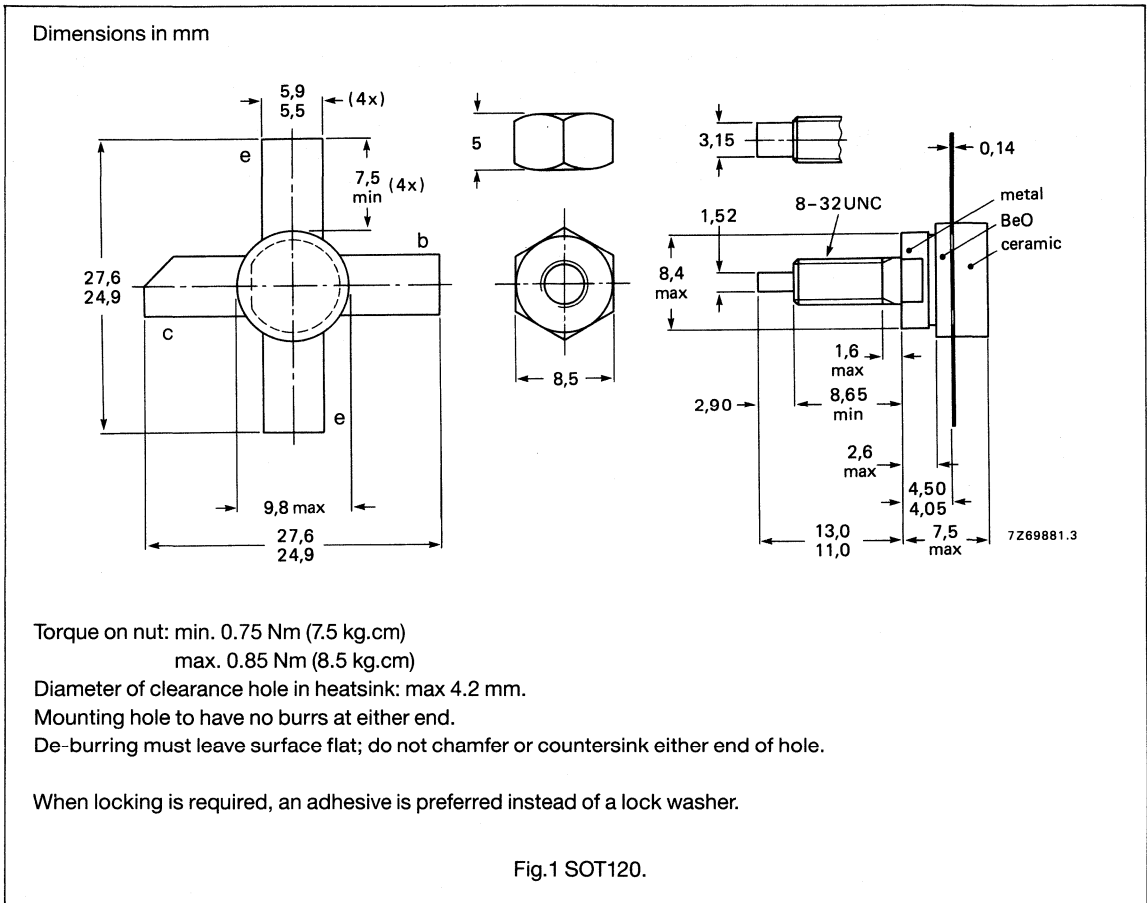
### WARNING

Product and environmental safety - toxic materials
<p><b>This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions.</b></p> <p><b>After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.</b></p>

## VHF power transistor

BLW30

## MECHANICAL DATA



## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector base voltage	open emitter	-	36	V
$V_{CEO}$	collector emitter voltage	open base	-	16	V
$V_{EBO}$	emitter base voltage	open collector	-	3	V
$I_C$	collector current	average	-	6	A
$I_{CM}$	collector current	peak value $f > 1$ MHz	-	18	A
$P_{tot}$	total power dissipation	$f > 1$ MHz $T_{mb} = 25$ °C	-	96	W
$T_{stg}$	storage temperature range		-65	150	°C
$T_j$	operating junction temperature		-	200.	°C

**VHF power transistor****BLW30****THERMAL RESISTANCE** $T_{mb} = 25\text{ }^{\circ}\text{C}$ ; dissipation = 48 W.

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$R_{th\ j-mb(RF)}$	from junction to mounting base (RF operation)		-	1.8	K/W
$R_{th\ mb-h}$	from mounting base to heatsink		-	0.45	K/W

**CHARACTERISTICS**at  $T_j = 25\text{ }^{\circ}\text{C}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter $I_C = 10\text{ mA}$	36	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base $I_C = 25\text{ mA}$	16	-	-	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector $I_E = 1\text{ mA}$	3	-	-	V
$I_{CES}$	collector-emitter leakage current	$V_{BE} = 0$ $V_{CE} = 16\text{ V}$	-	-	10	mA
$h_{FE}$	DC current gain	$I_C = 4\text{ A}$ $V_{CE} = 5\text{ V}$	25	40	-	
$f_T$	transition frequency at $f = 500\text{ MHz}$	$I_C = 4\text{ A}$ $V_{CE} = 12.5\text{ V}$	-	1.5	-	GHz
$C_c$	collector capacitance at $f = 1\text{ MHz}$	$I_E = I_e = 0$ $V_{CB} = 12.5\text{ V}$	-	87	-	pF
$C_{re}$	feedback capacitance	$V_{CE} = 12.5\text{ V}$ $I_C = 0$ $f = 1\text{ MHz}$	-	47	-	pF
$C_{cs}$	collector-stud capacitance		-	2	-	pF

**APPLICATION INFORMATION**RF performance in c.w. operation (common-emitter circuit); class-B operation at  $T_h = 25\text{ }^{\circ}\text{C}$ ,  $R_{th\ mb-h} = 0.45\text{ K/W}$ , unless otherwise specified.

MODE OF OPERATION	f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$G_p$ (dB)	$\eta_c$ (%)
c.w. class-B	175	12.5	30	> 10.0 typ. 11.5	> 55 typ. 60

**Ruggedness in class-B operation**

The BLW30 is capable of withstanding a load mismatch corresponding to  $V_{SWR} = 50$  through all phases, up to a supply voltage of 15.5 V ( $P_L = 30\text{ W}$  and  $f = 175\text{ MHz}$ ).

## VHF power transistor

BLW30

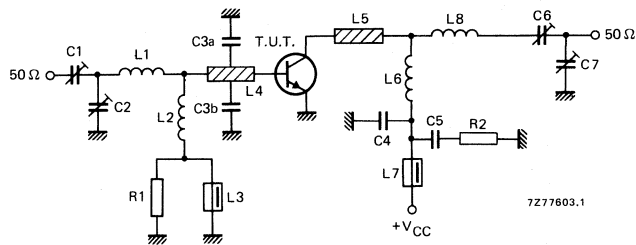


Fig.2 Test circuit for 175 MHz.

## List of components (Fig. 2)

DESIGNATION	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	film dielectric trimmer	2.5 to 20 pF		2222 809 07004
C2, C7	film dielectric trimmer	4 to 40 pF		2222 809 07008
C3a, C3b	500 V ceramic capacitor	47 pF		
C4	ceramic capacitor	120 pF		
C5	polyester capacitor	100 nF		
C6	film dielectric trimmer	7 to 100 pF		2222 809 07015
L1	1/2 turn 1.6 mm copper wire		int. dia. 6 mm leads 2 x 5 mm	
L2	7 turns 0.5 mm closely wound enameled copper wire	100 nH	int. dia. 3 mm leads 2 x 5 mm	
L3, L7	grade 3B Ferroxcube wide-band HF choke			4312 020 36640
L4, L5	stripline note 1		12 x 6 mm	
L6	3.5 turns 1.6 mm closely wound enameled copper wire		int. dia. 6 mm leads 2 x 5 mm	
L8	1 turn 1.6 mm copper wire		int. dia. 6 mm leads 2 x 5 mm	
R1, R2	carbon resistor	10 Ω		

## Notes

- L4 and L5 are strips on a double copper-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16 inch.

## VHF power transistor

BLW30

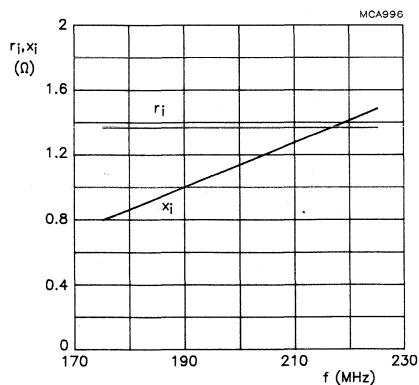


Fig.3 Input impedance, series components;  
 $V_{CE} = 12.5$  V,  $P_L = 30$  W,  $T_h = 25$  °C,  
 $R_{th\ mb-h} = 0.45$  K/W; typical values.

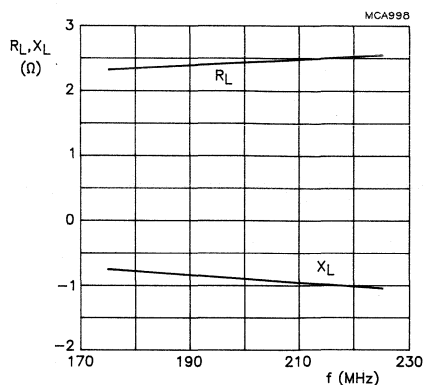


Fig.4 Load impedance, series components;  
 $V_{CE} = 12.5$  V,  $P_L = 30$  W,  $T_h = 25$  °C,  
 $R_{th\ mb-h} = 0.45$  K/W; typical values.

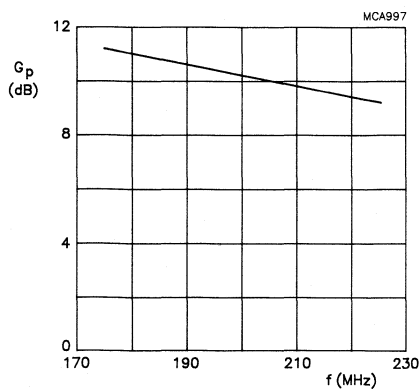


Fig.5 Power gain;  $V_{CE} = 12.5$  V,  $P_L = 30$  W,  
 $T_h = 25$  °C,  $R_{th\ mb-h} = 0.45$  K/W; typical values.



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B or C operated mobile transmitters with a nominal supply voltage of 13,5 V. Because of the high gain and excellent power handling capability, the transistor is especially suited for design of wide-band and semi-wide-band v.h.f. amplifiers. Together with a BFO43 driver stage, the chain can deliver 28 W with a maximum drive power of 250 mW at 175 MHz. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

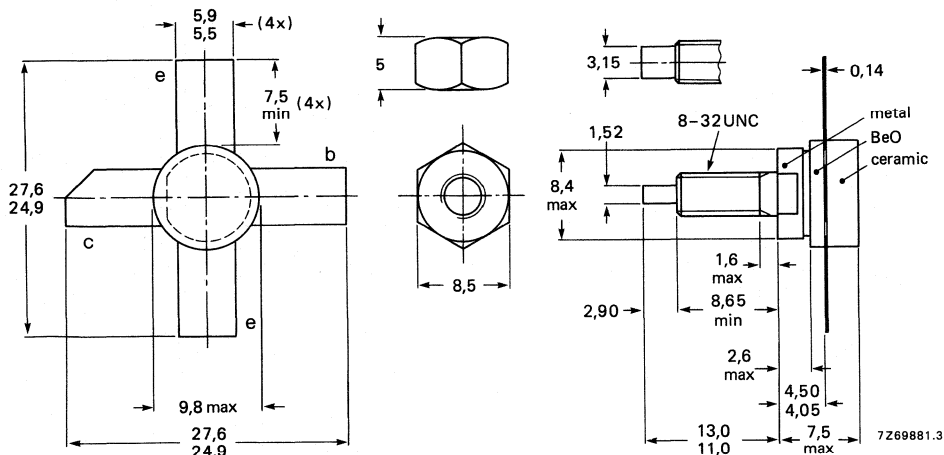
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w. class-B	13,5	175	28	> 9	> 60	$0,9 + j0,9$	$380 + j40$
c.w. class-B	12,5	175	28	typ. 9,5	typ. 70	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value

$V_{CESM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_{C(AV)}$  max. 6 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 15 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 96 W

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

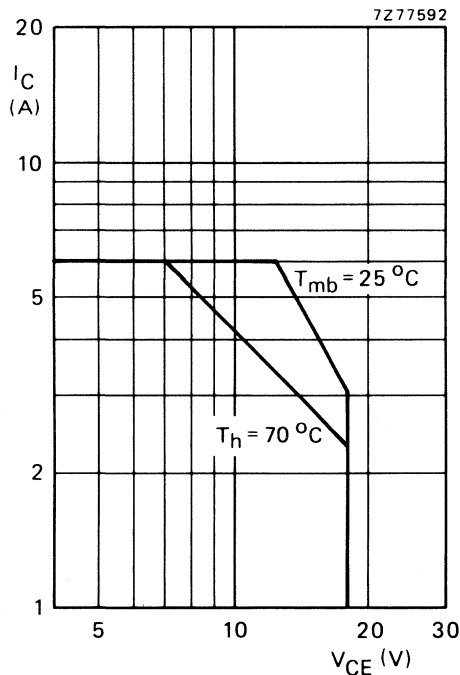


Fig. 2 D.C. SOAR.

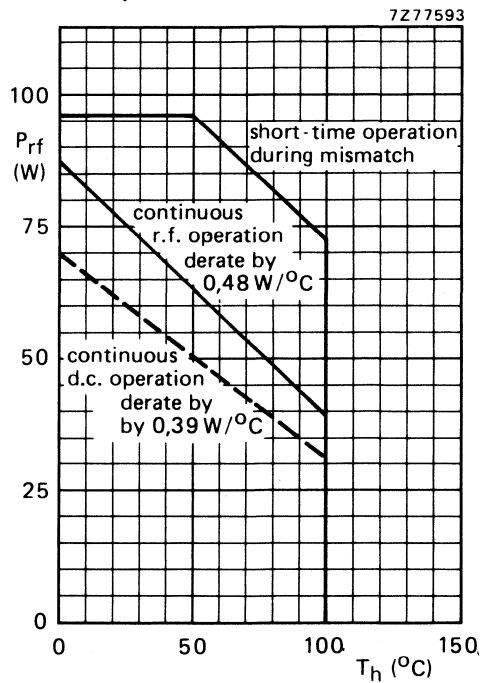


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f \geq 1$  MHz.

**THERMAL RESISTANCE** (dissipation = 25 W;  $T_{mb} = 81$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th\ j-mb(dc)}$  = 2,4 K/W

From junction to mounting base (r.f. dissipation)

$R_{th\ j-mb(rf)}$  = 1,85 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,45 K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 25\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 100\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 10\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\text{ }\Omega$  $E_{SBO} > 8\text{ mJ}$  $E_{SBR} > 8\text{ mJ}$ 

D.C. current gain\*

 $I_C = 3,5\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 80

Collector-emitter saturation voltage\*

 $I_C = 10\text{ A}; I_B = 2\text{ A}$  $V_{CEsat}$  typ. 1,8 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 3,5\text{ A}; V_{CB} = 13,5\text{ V}$  $-I_E = 10\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 850 MHz $f_T$  typ. 700 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 13,5\text{ V}$  $C_c$  typ. 92 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 13,5\text{ V}$  $C_{re}$  typ. 58 pF

Collector-stud capacitance

 $C_{cs}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

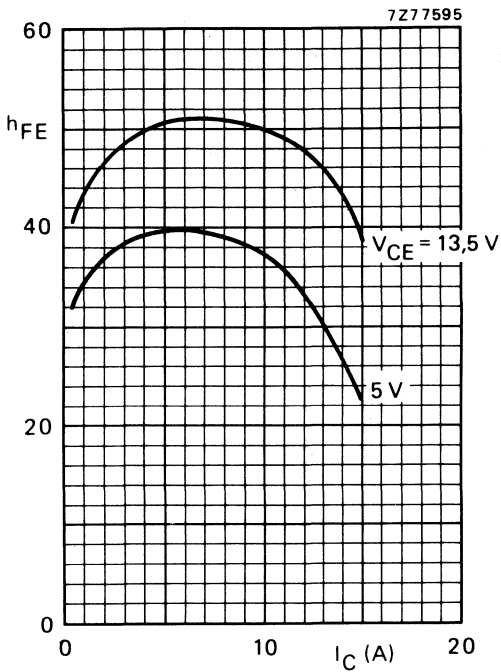


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

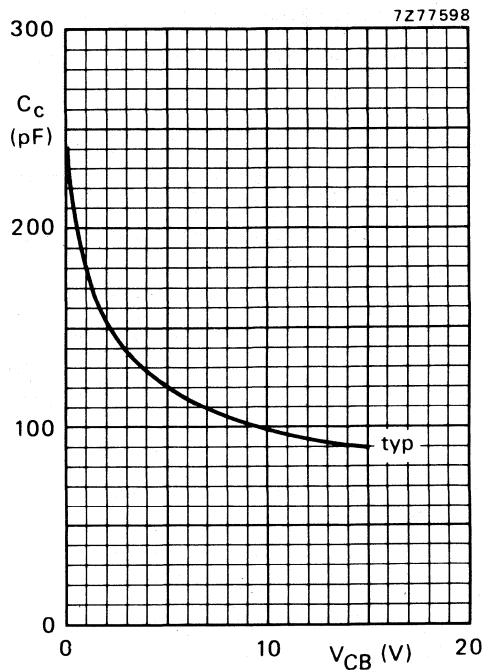


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

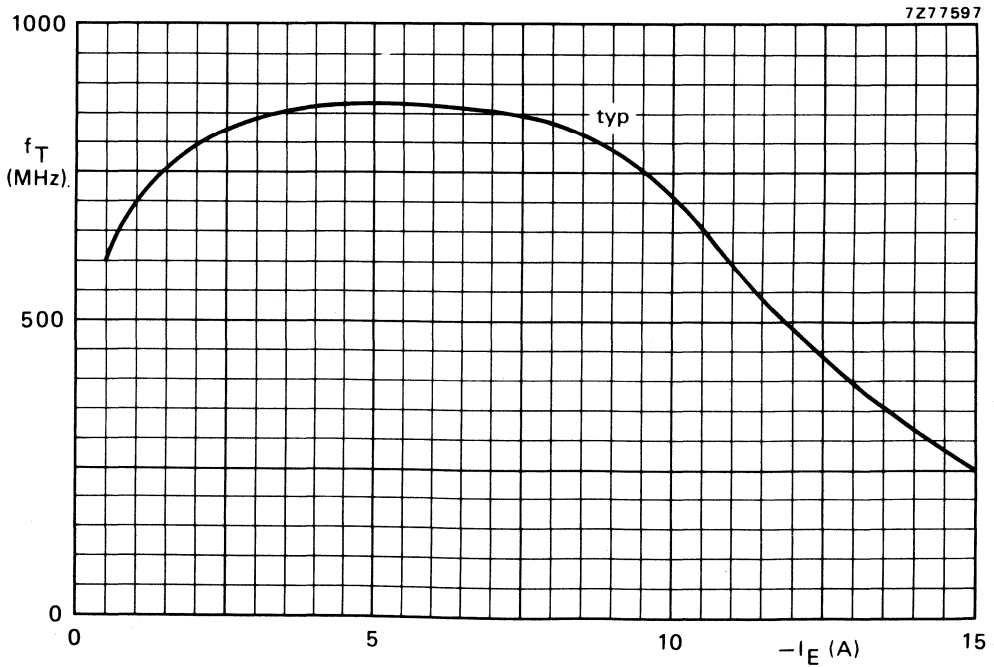


Fig. 6  $V_{CB} = 13.5\text{ V}$ ;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	13,5	28	< 3,5	> 9	< 3,45	> 60	$0,9 + j0,9$	$380 + j40$
175	12,5	28	typ. 3,15	typ. 9,5	typ. 3,2	typ. 70	—	—

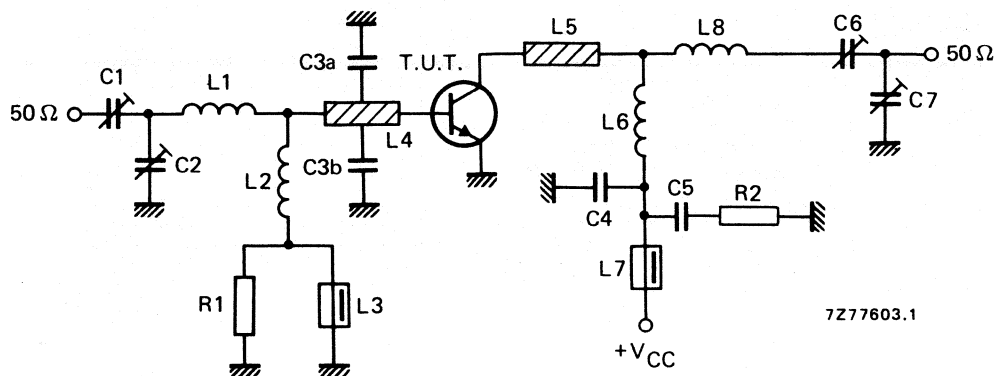


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C7 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor

C5 = 100 nF polyester capacitor

C6 = 7 to 100 pF film dielectric trimmer (cat. no. 2222 809 07015)

L1 =  $\frac{1}{2}$  turn Cu wire (1,6 mm); int. dia. 6,0 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L7 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L6 =  $3\frac{1}{2}$  turns closely wound enamelled Cu wire (1,6 mm) int. dia. 6,0 mm; leads 2 x 5 mm

L8 = 1 turn Cu wire (1,6 mm) int. dia. 6,0 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit are shown in Fig. 8.

APPLICATION INFORMATION (continued)

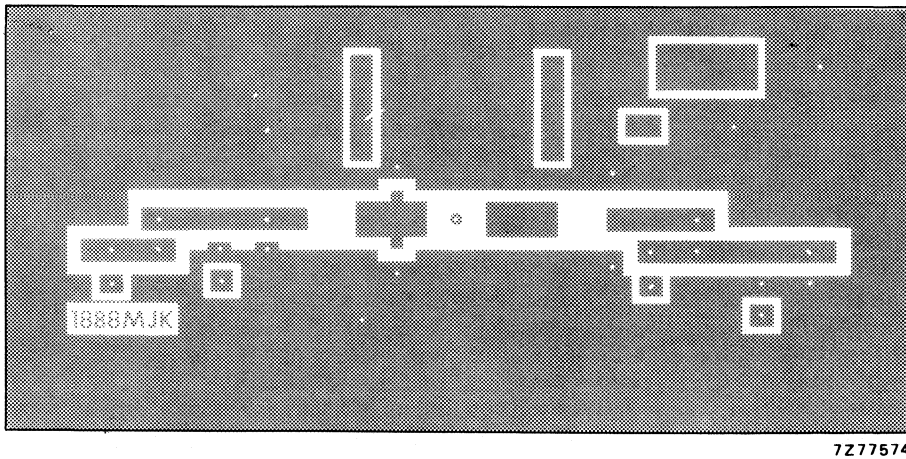
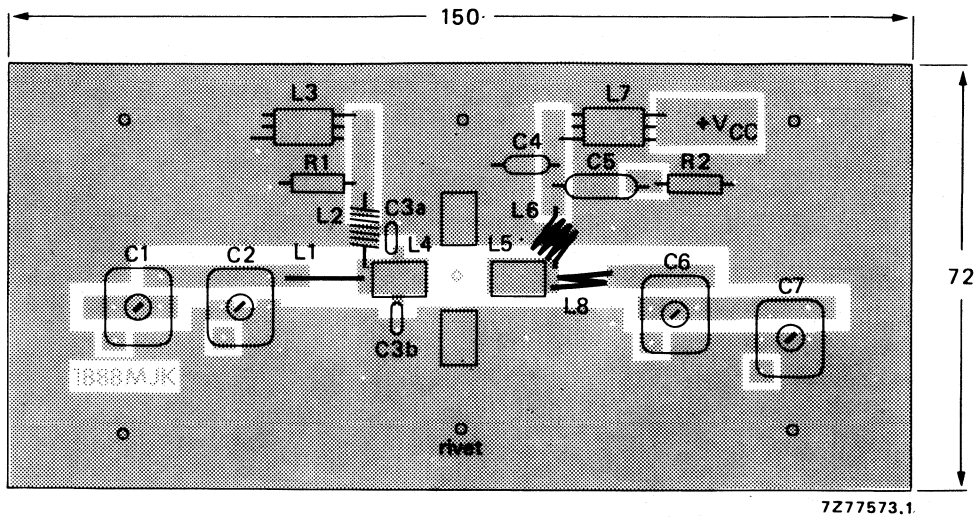


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

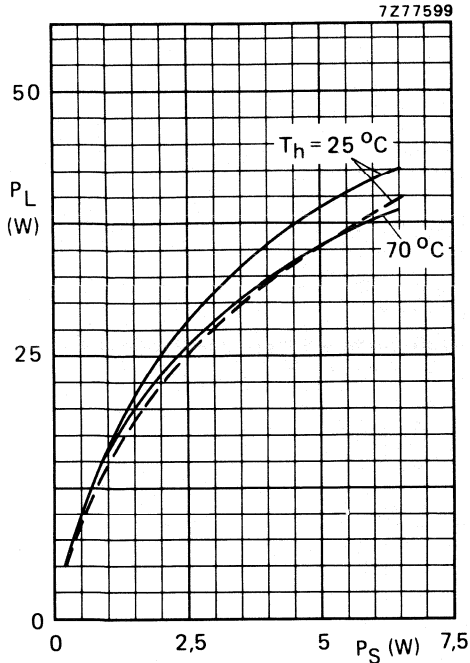


Fig. 9 Typical values;  $f = 175$  MHz;  
 —  $V_{CE} = 13,5$  V; - - -  $V_{CE} = 12,5$  V.

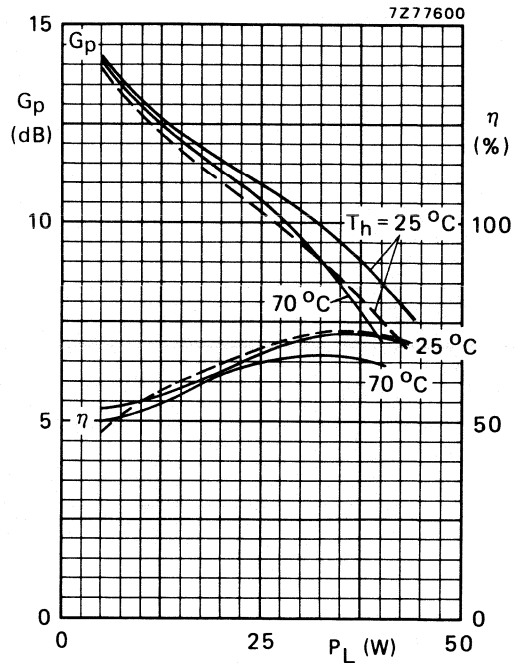


Fig. 10 Typical values;  $f = 175$  MHz;  
 —  $V_{CE} = 13,5$  V; - - -  $V_{CE} = 12,5$  V.

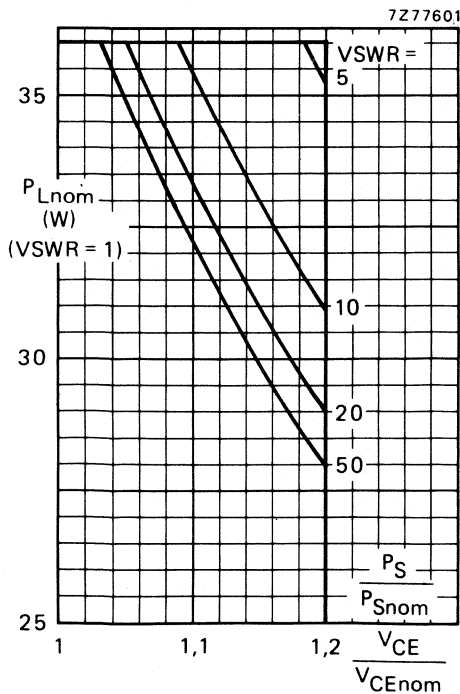


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175$  MHz;  $T_h = 70$  °C;  
 $R_{th\ mb-h} = 0,45$  K/W;  $V_{CEnom} = 13,5$  V or 12,5 V;  $P_S = P_{Snom}$  at  $V_{CEnom}$  and  $VSWR = 1$

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ), as a function of the expected supply over-voltage ratio with  $VSWR$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 50 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

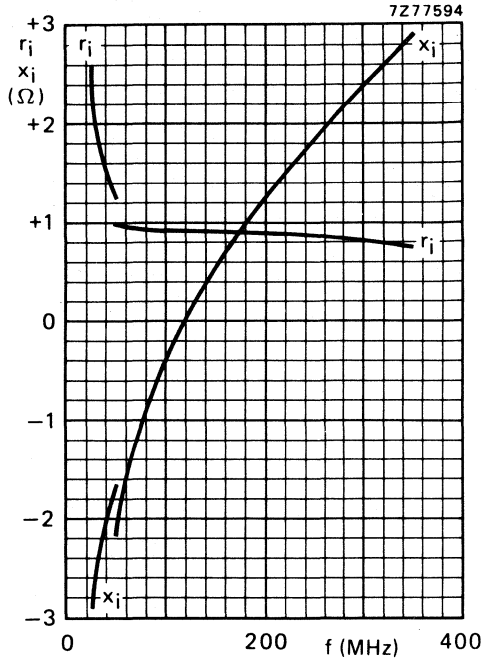


Fig. 12.

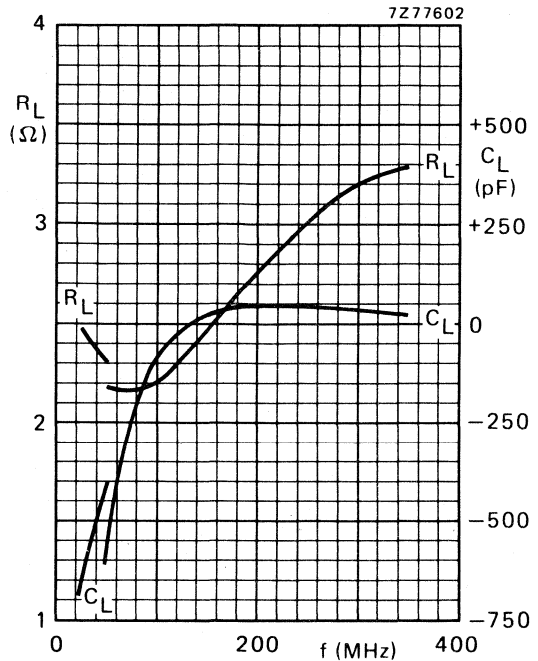
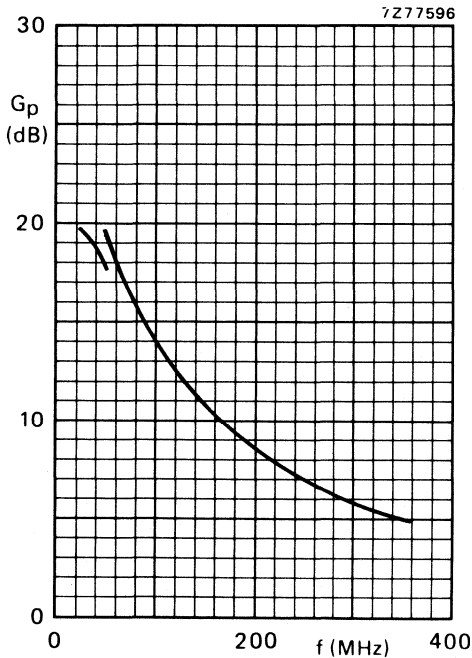


Fig. 13.



Conditions for Figs 12, 13 and 14:  
 Typical values;  $V_{CE} = 13,5$  V;  $P_L = 28$  W;  
 $T_h = 25$   $^{\circ}$ C.

Fig. 14.

## U.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in **linear u.h.f. amplifiers** for television transmitters and transposers. The **excellent d.c. dissipation properties** for class-A operation are obtained by means of diffused emitter ballasting resistors and a multi-base structure, providing an optimum temperature profile on the crystal area. The combination of optimum thermal design and the application of **gold sandwich metallization** realizes excellent reliability properties.

The transistor has a ¼" capstan envelope with ceramic cap.

### QUICK REFERENCE DATA

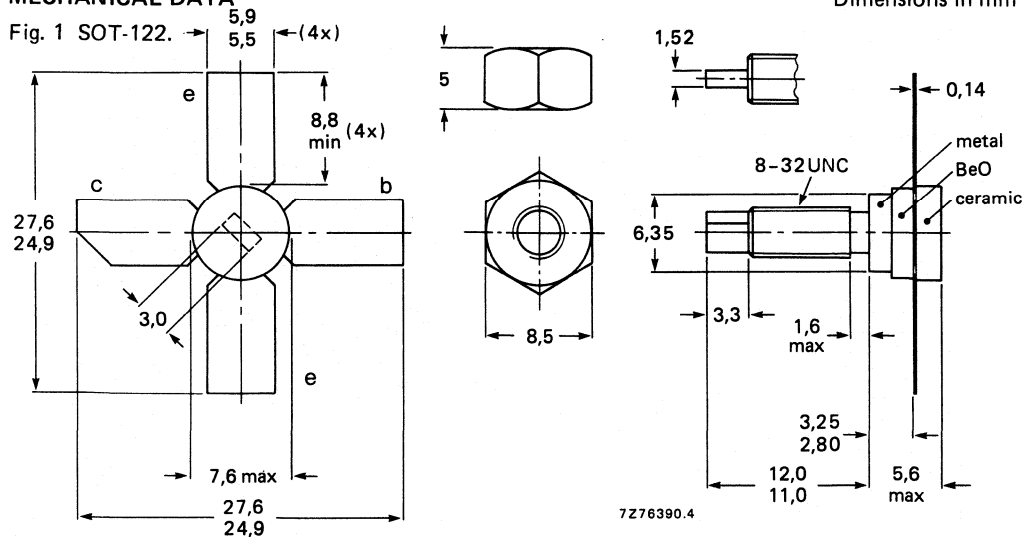
R.F. performance

mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ mA	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{O sync}}^*$ W	$G_{\text{p}}$ dB
class-A; linear amplifier	860	25	150	70	-60	> 0,5	> 11
	860	25	150	25	-60	typ. 0,63	typ. 12,2

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or  
countersink either end of hole.

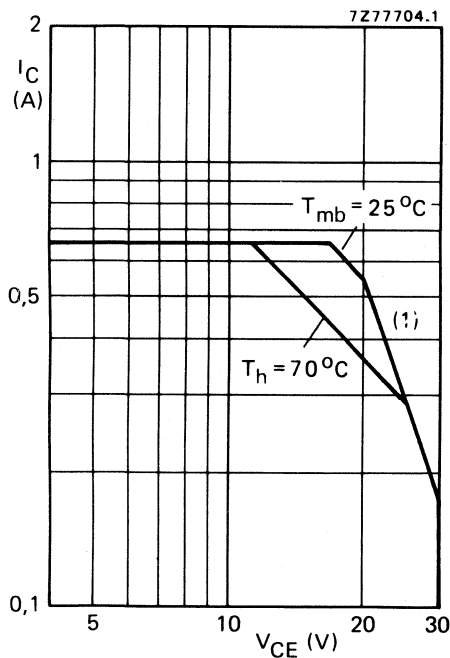
When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak value); $V_{BE} = 0$ open base	$V_{CESM}$	max.	50 V
Emitter-base voltage (open collector)	$V_{CEO}$	max.	30 V
Collector current d.c. or average (peak value); $f > 1$ MHz	$V_{EBO}$	max.	4 V
Total power dissipation up to $T_{mb} = 25$ °C	$I_C$	max.	650 mA
Storage temperature	$I_{CM}$	max.	1000 mA
Operating junction temperature	$P_{tot}$	max.	10,8 W
	$T_{stg}$		-65 to +150 °C
	$T_j$	max.	200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

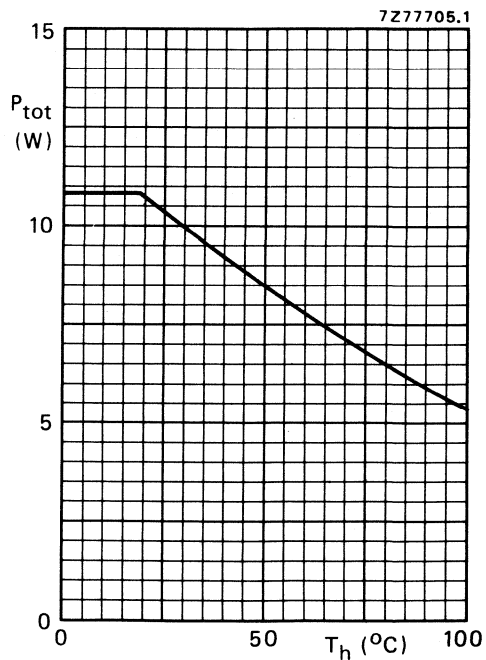


Fig. 3 Power derating curve vs. temperature.

**THERMAL RESISTANCE** (see Fig. 4)

From junction to mounting base  
(dissipation = 3,75 W;  $T_{mb} = 72,3$  °C; i.e.  $T_h = 70$  °C)

$R_{th\ j-mb} = 15,0$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0,6$  K/W



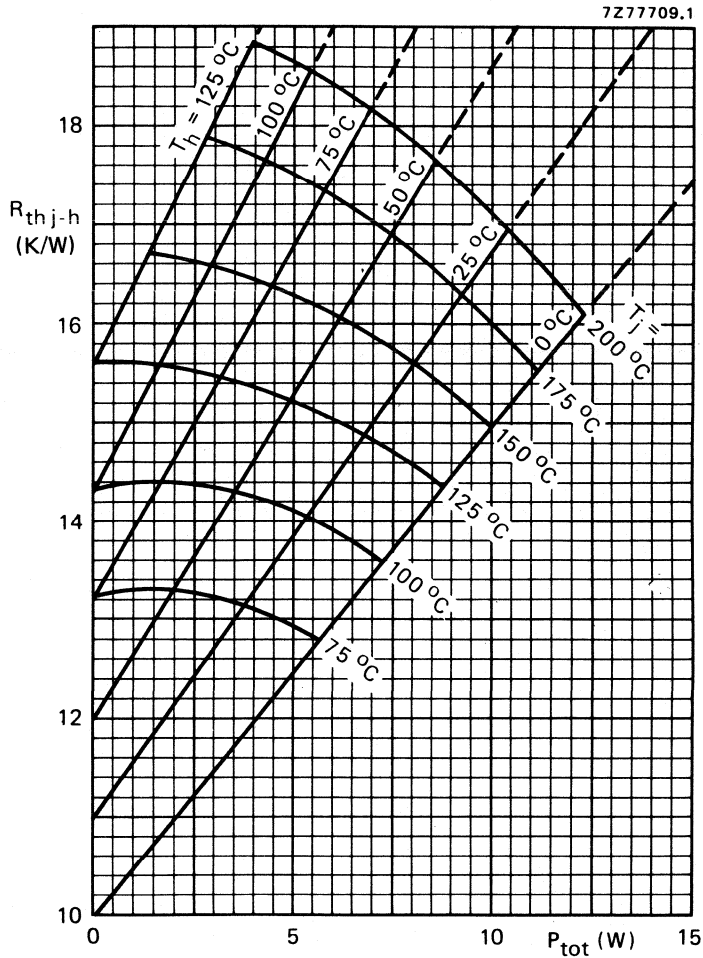


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,6$  K/W.)

#### Example

Nominal class-A operation:  $V_{CE} = 25$  V;  $I_C = 150$  mA;  $T_h = 70$  °C.

Fig. 4 shows:  $R_{th\ j-h}$  max. 15,6 K/W  
 $T_j$  max. 130 °C

Typical device:  $R_{th\ j-h}$  typ. 13,5 K/W  
 $T_j$  typ. 120 °C

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$$V_{BE} = 0; I_C = 2\text{ mA}$$

open base;  $I_C = 15\text{ mA}$

$$V_{(BR)CES} > 50\text{ V}$$

$$V_{(BR)CEO} > 30\text{ V}$$

Emitter-base breakdown voltage

open collector;  $I_E = 1\text{ mA}$

$$V_{(BR)EBO} > 4\text{ V}$$

Collector cut-off current

$$V_{BE} = 0; V_{CE} = 30\text{ V}$$

$$V_{BE} = 0; V_{CE} = 30\text{ V}; T_j = 175\text{ }^\circ\text{C}$$

$$I_{CES} < 0,5\text{ mA}$$

$$I_{CES} < 1,2\text{ mA}$$

D.C. current gain \*

$$I_C = 150\text{ mA}; V_{CE} = 25\text{ V}$$

$$h_{FE} > 20$$

$$\text{typ. } 40$$

$$I_C = 150\text{ mA}; V_{CE} = 25\text{ V}; T_j = 175\text{ }^\circ\text{C}$$

$$h_{FE} < 120$$

Collector-emitter saturation voltage \*

$$I_C = 300\text{ mA}; I_B = 30\text{ mA}$$

$$V_{CEsat} \text{ typ. } 500\text{ mV}$$

Transition frequency at  $f = 500\text{ MHz}$  \*\*

$$-I_E = 150\text{ mA}; V_{CB} = 25\text{ V}$$

$$-I_E = 300\text{ mA}; V_{CB} = 25\text{ V}$$

$$f_T \text{ typ. } 3,5\text{ GHz}$$

$$f_T \text{ typ. } 3,4\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 25\text{ V}$$

$$C_c \text{ typ. } 3,7\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 10\text{ mA}; V_{CE} = 25\text{ V}$$

$$C_{re} \text{ typ. } 1,9\text{ pF}$$

Collector-stud capacitance

$$C_{cs} \text{ typ. } 1,2\text{ pF}$$

\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}$ ;  $\delta \leq 0,02$ .

\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}$ ;  $\delta \leq 0,01$ .

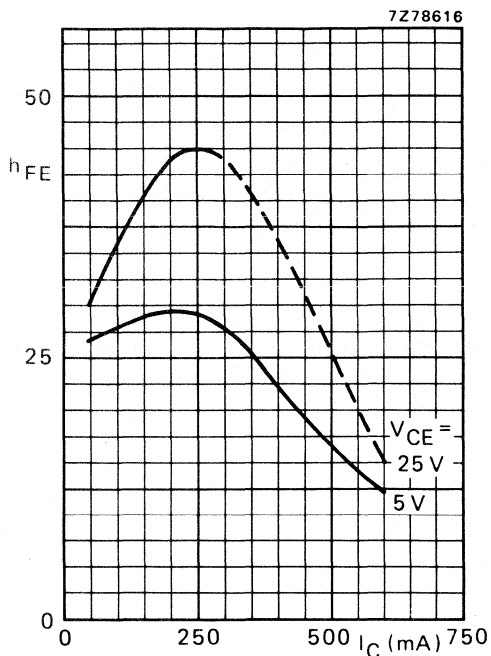


Fig. 5 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

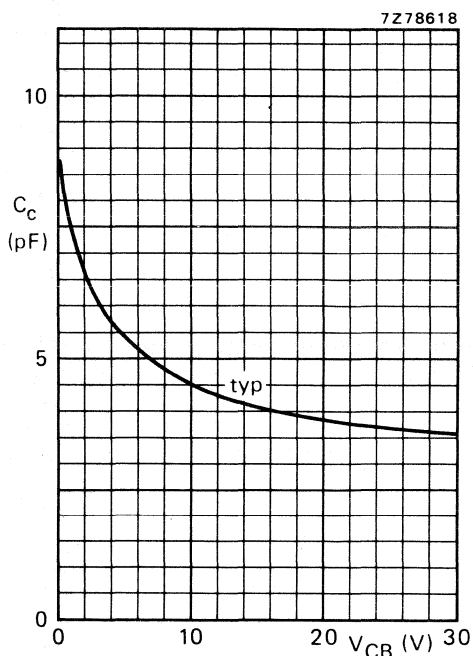


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

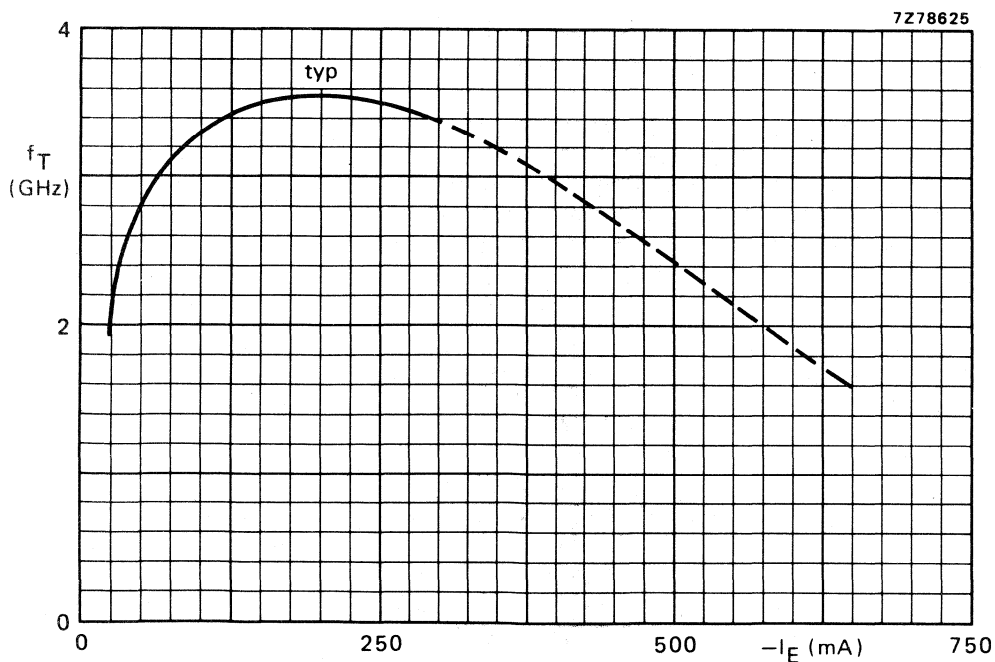


Fig. 7  $V_{CB} = 25\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (mA)	$T_{\text{h}}$ (°C)	$d_{\text{im}}$ (dB) *	$P_{\text{Osync}}$ (W) *	$G_{\text{p}}$ (dB)
860	25	150	70	-60	> 0,5	> 11
860	25	150	70	-60	typ. 0,58	typ. 12,2
860	25	150	25	-60	typ. 0,63	typ. 12,2

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

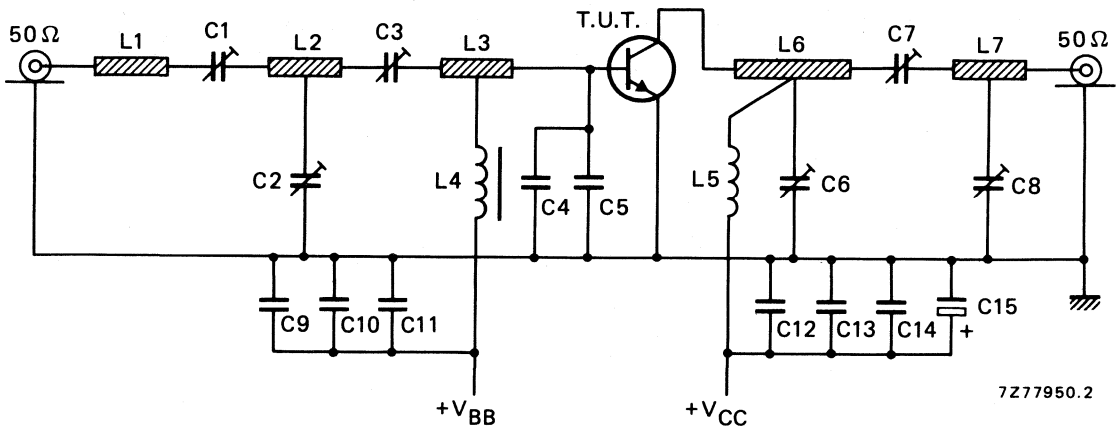


Fig. 8 Test circuit at  $f_{\text{vision}} = 860$  MHz.

List of components:

C1 = C7 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 05003)

C2 = C6 = C8 = 1 to 3,5 pF film dielectric trimmer (cat. no. 2222 809 05001) placed 24 mm, 17 mm and 45 mm respectively from transistor edge

C3 = 1,8 to 10 pF film dielectric trimmer (cat. no. 2222 809 05002)

C4 = C5 = 3 pF multilayer chip capacitor (ATC 100A-3RO-C-PX-50)

C9 = C12 = 1 nF chip capacitor

C10 = 100 nF polyester capacitor

C11 = C13 = 470 nF polyester capacitor

C14 = 10 nF polyester capacitor

C15 = 3,3  $\mu$ F/40 V solid aluminium electrolytic capacitor

L1 = stripline (5,0 mm x 4,5 mm)

L2 = stripline (13,2 mm x 4,5 mm)

L3 = stripline (15,0 mm x 4,5 mm)

L4 = micro choke 0,47  $\mu$ H (cat. no. 4322 057 04770)

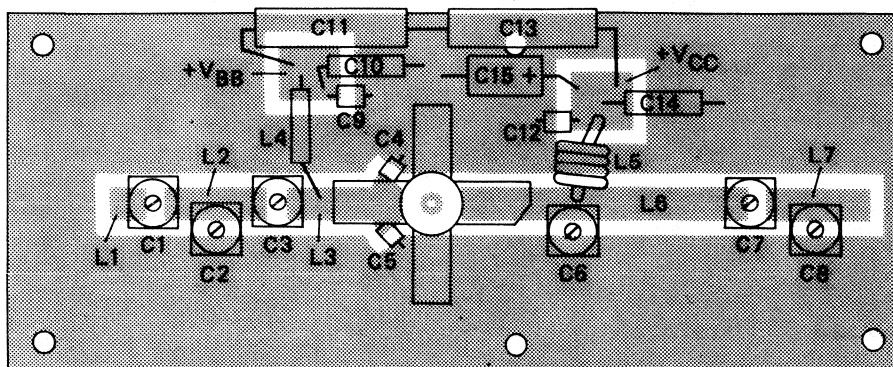
L5 = 4 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 5,5 mm; leads 2 x 4 mm

L6 = stripline (37,0 mm x 4,5 mm)

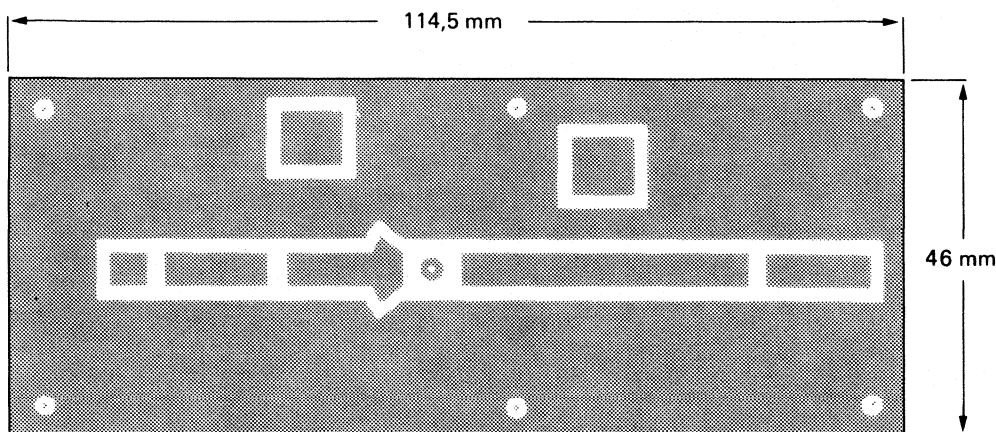
L7 = stripline (13,5 mm x 4,5 mm)

L1; L2; L3; L6 and L7 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16".

Component layout and printed-circuit board for 860 MHz test circuit are shown in Fig. 9. For bias circuit see Fig. 10.



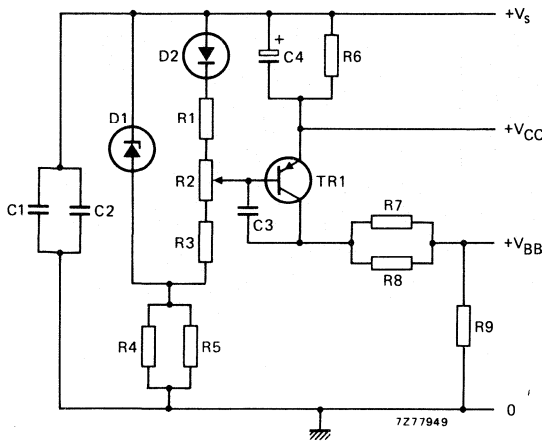
7Z78881



7Z78878

Fig. 9 Component layout and printed-circuit board for 860 MHz test circuit.

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.



List of components:

- C1 = 100 pF ceramic capacitor
- C2 = C3 = 100 nF polyester capacitor
- C4 = 10 μF/25 V solid aluminium electrolytic capacitor
- R1 = 150 Ω carbon resistor (0,25 W)
- R2 = 100 Ω preset potentiometer (0,1 W)
- R3 = 82 Ω carbon resistor (0,25 W)
- R4 = R5 = 2,2 kΩ carbon resistor (0,25 W)
- R6 = 12 Ω carbon resistor (0,5 W)
- R7 = R8 = 820 Ω carbon resistor (0,25 W)
- R9 = 33 Ω carbon resistor (0,25 W)
- D1 = BZY88-C3V3
- D2 = BY206
- TR1 = BD136

Fig. 10 Bias circuit for class-A amplifier at  $f_{\text{vision}} = 860 \text{ MHz}$ .

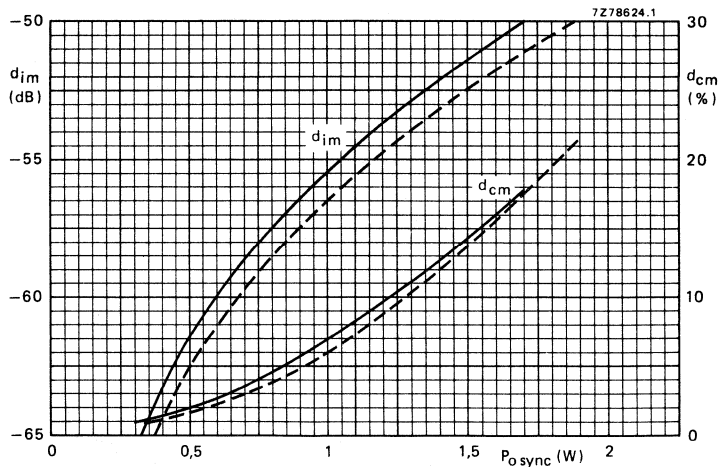


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and cross-modulation distortion ( $d_{cm}$ )\*\* as a function of output power. Typical values;  $V_{CE} = 25 \text{ V}$ ;  $I_C = 150 \text{ mA}$ ;  $f_{\text{vision}} = 860 \text{ MHz}$ ; ---  $T_h = 25 \text{ }^\circ\text{C}$ ; —  $T_h = 70 \text{ }^\circ\text{C}$ .

Information for wideband application from 470 to 860 MHz available on request.

\* Three-tone test method (vision carrier  $-8 \text{ dB}$ , sound carrier  $-7 \text{ dB}$ , sideband signal  $-16 \text{ dB}$ ), zero dB corresponds to peak sync level. Intermodulation distortion of input signal  $\leq -75 \text{ dB}$ .

\*\* Two-tone test method (vision carrier  $0 \text{ dB}$ , sound carrier  $-7 \text{ dB}$ ), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from  $0 \text{ dB}$  to  $-20 \text{ dB}$ .

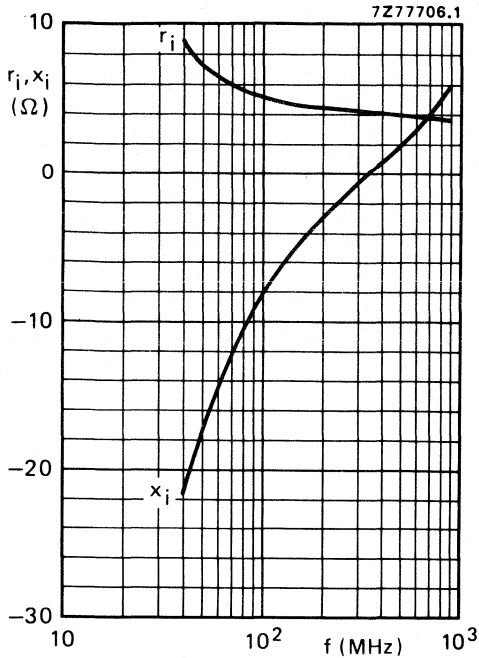


Fig. 12 Input impedance (series components).

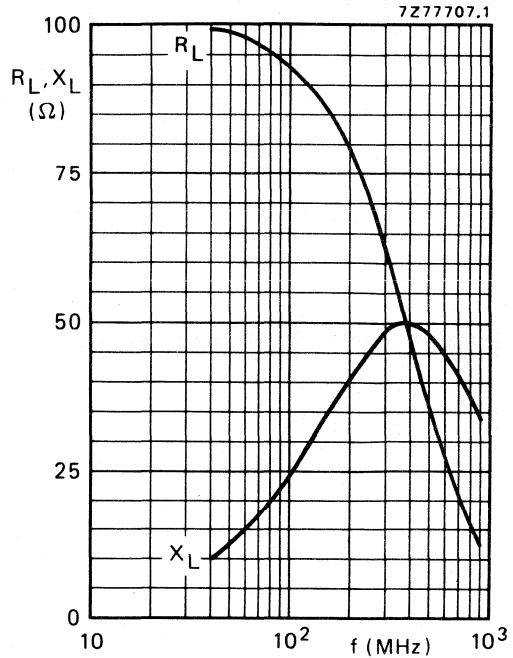


Fig. 13 Load impedance (series components).

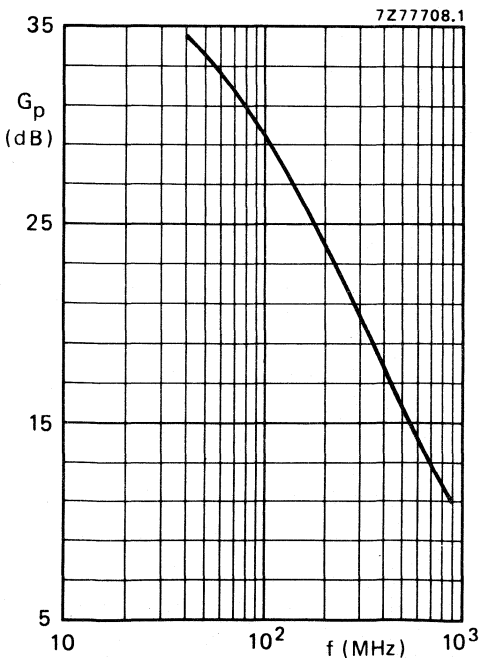


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 25$  V;  $I_C = 150$  mA;  
 $T_h = 70$  °C.

**Ruggedness**

The BLW32 is capable of withstanding a load mismatch (VSWR = 50 through all phases) under the following conditions:

$f = 860$  MHz;  $V_{CE} = 25$  V;  $I_C = 150$  mA;  
 $T_h = 70$  °C and  $P_L = 1$  W.





## U.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in **linear u.h.f. amplifiers** for television transmitters and transposers. The **excellent d.c. dissipation properties** for class-A operation are obtained by means of diffused emitter ballasting resistors and a multi-base structure, providing an optimum temperature profile on the crystal area. The combination of optimum thermal design and the application of **gold sandwich metallization** realizes excellent reliability properties.

The transistor has a ¼" capstan envelope with ceramic cap.

### QUICK REFERENCE DATA

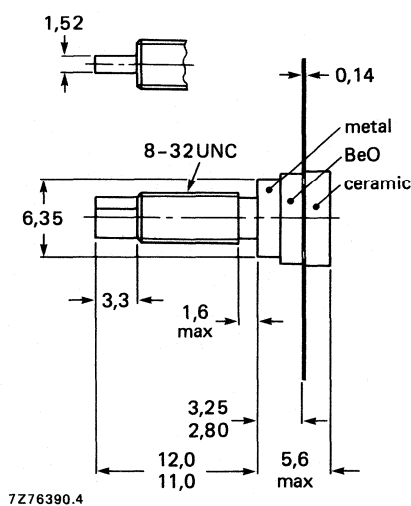
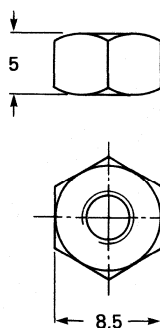
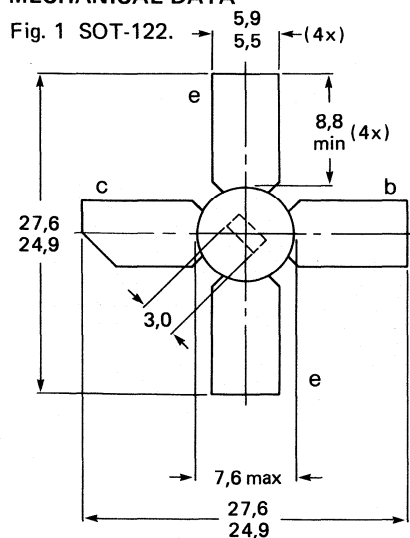
R.F. performance

mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ mA	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{O sync}}^*$ W	$G_{\text{p}}$ dB
class-A; linear amplifier	860	25	300	70	-60	> 1,0	> 10,0
	860	25	300	25	-60	typ. 1,15	typ. 10,5

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

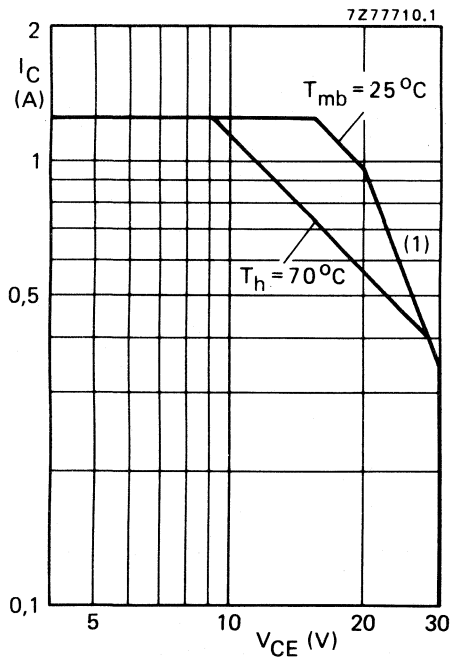
When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak value); $V_{BE} = 0$	$V_{CESM}$	max.	50 V
open base	$V_{CEO}$	max.	30 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average	$I_C$	max.	1,25 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	1,9 A
Total power dissipation up to $T_{mb} = 25\text{ }^\circ\text{C}$	$P_{tot}$	max.	19,3 W
Storage temperature	$T_{stg}$		-65 to +150 $^\circ\text{C}$
Operating junction temperature	$T_j$	max.	200 $^\circ\text{C}$



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

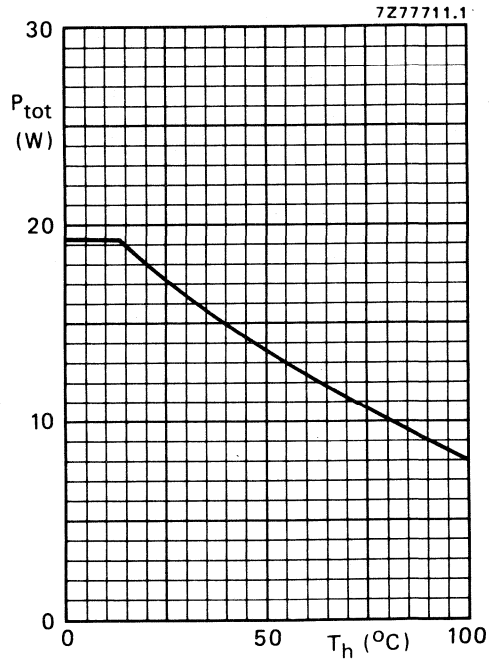


Fig. 3 Power derating curve vs. temperature.

**THERMAL RESISTANCE** (see Fig. 4)

From junction to mounting base  
(dissipation = 7,5 W;  $T_{mb} = 74,5\text{ }^\circ\text{C}$ ; i.e.  $T_h = 70\text{ }^\circ\text{C}$ )

From mounting base to heatsink

$R_{th\ j-mb}$	=	10,1 K/W
$R_{th\ mb-h}$	=	0,6 K/W

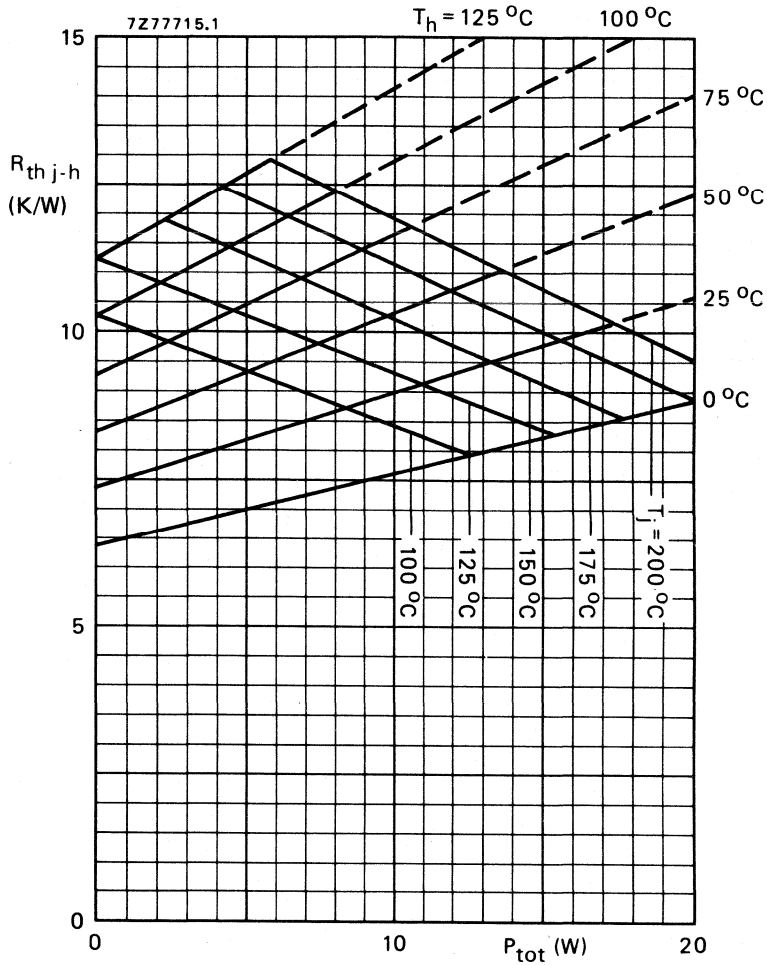


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,6\text{ K/W.}$ )

**Example**

Nominal class-A operation:  $V_{CE} = 25\text{ V}$ ;  $I_C = 300\text{ mA}$ ;  $T_h = 70\text{ }^\circ\text{C}$ .

Fig. 4 shows:  $R_{th\ j-h}$  max. 10,7 K/W  
 $T_j$  max. 150 °C

Typical device:  $R_{th\ j-h}$  typ. 8,25 K/W  
 $T_j$  typ. 132 °C

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$$V_{BE} = 0; I_C = 4\text{ mA}$$

open base;  $I_C = 30\text{ mA}$

$$V_{(BR)CES} > 50\text{ V}$$

$$V_{(BR)CEO} > 30\text{ V}$$

Emitter-base breakdown voltage

open collector;  $I_E = 2\text{ mA}$

$$V_{(BR)EBO} > 4\text{ V}$$

Collector cut-off current

$$V_{BE} = 0; V_{CE} = 30\text{ V}$$

$$V_{BE} = 0; V_{CE} = 30\text{ V}; T_j = 175\text{ }^\circ\text{C}$$

$$I_{CES} < 1,0\text{ mA}$$

$$I_{CES} < 2,5\text{ mA}$$

D.C. current gain

$$I_C = 300\text{ mA}; V_{CE} = 25\text{ V}$$

$$h_{FE} > 20$$

$$\text{typ. } 40$$

$$I_C = 300\text{ mA}; V_{CE} = 25\text{ V}; T_j = 175\text{ }^\circ\text{C}$$

$$h_{FE} < 120$$

Collector-emitter saturation voltage \*

$$I_C = 600\text{ mA}; I_B = 60\text{ mA}$$

$$V_{CEsat} \text{ typ. } 450\text{ mV}$$

Transition frequency at  $f = 500\text{ MHz}$  \*\*

$$-I_E = 300\text{ mA}; V_{CB} = 25\text{ V}$$

$$f_T \text{ typ. } 3,4\text{ GHz}$$

$$-I_E = 600\text{ mA}; V_{CB} = 25\text{ V}$$

$$f_T \text{ typ. } 3,1\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 25\text{ V}$$

$$C_C \text{ typ. } 6,6\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 20\text{ mA}; V_{CE} = 25\text{ V}$$

$$C_{re} \text{ typ. } 3,5\text{ pF}$$

Collector-stud capacitance

$$C_{cs} \text{ typ. } 1,2\text{ pF}$$

\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}$ ;  $\delta \leq 0,02$ .

\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}$ ;  $\delta \leq 0,01$ .

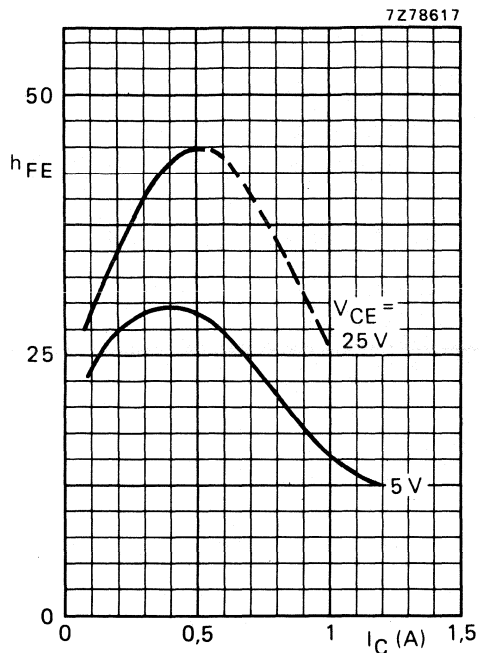


Fig. 5 Typical values;  $T_j = 25$  °C.

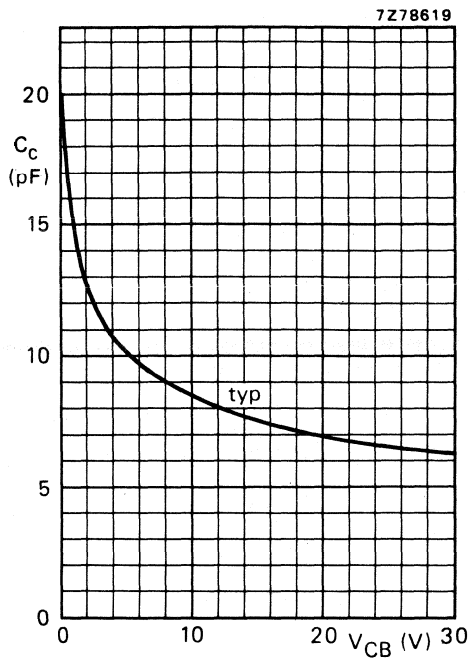


Fig. 6  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.

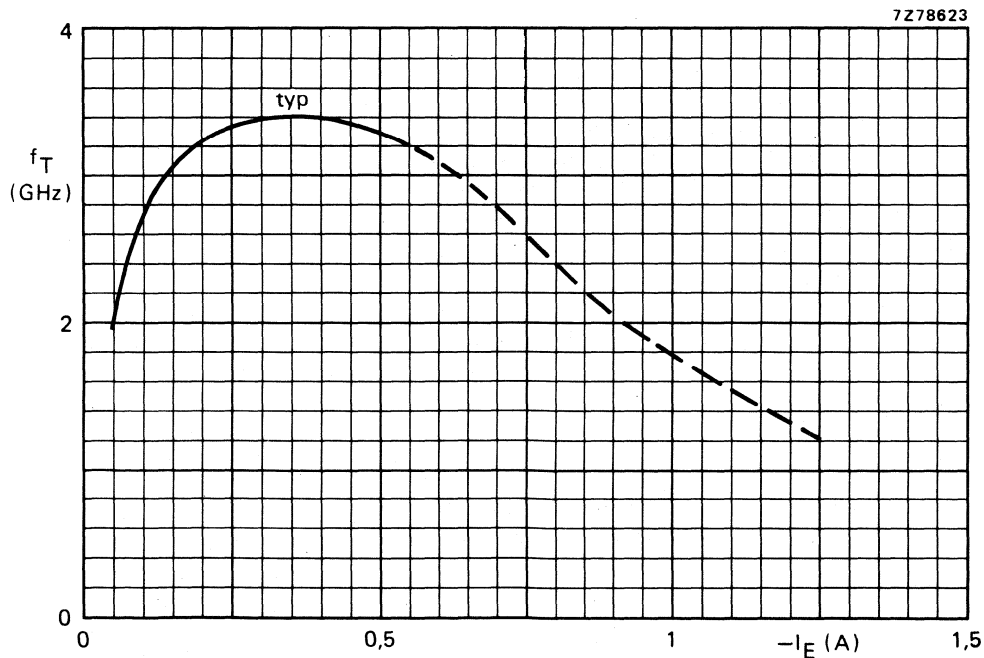


Fig. 7  $V_{CB} = 25$  V;  $f = 500$  MHz;  $T_j = 25$  °C.

## APPLICATION INFORMATION

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (mA)	$T_{\text{h}}$ ( $^{\circ}\text{C}$ )	$d_{\text{im}}$ (dB) *	$P_{\text{o sync}}$ (W) *	$G_{\text{p}}$ (dB)
860	25	300	70	-60	> 1,0	> 10
860	25	300	70	-60	typ. 1,07	typ. 10,5
860	25	300	25	-60	typ. 1,15	typ. 10,5

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

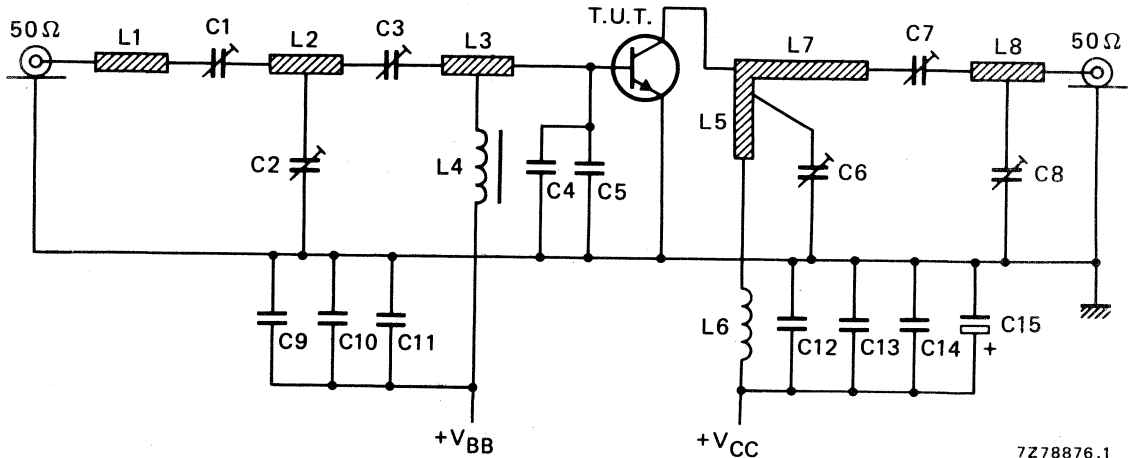


Fig. 8 Test circuit at  $f_{\text{vision}} = 860$  MHz.

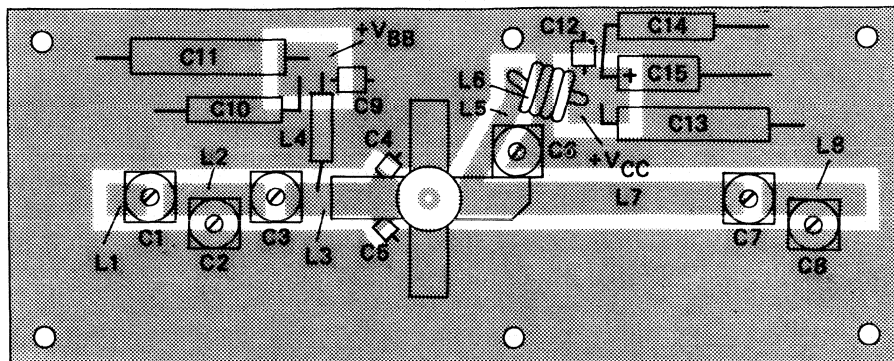
List of components:

- C1 = C3 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 05003)
- C2 = C6 = C8 = 1 to 3,5 pF film dielectric trimmer (cat. no. 2222 809 05001) placed 24 mm, 8 mm and 46 mm respectively from transistor edge
- C4 = C5 = 4,3 pF multilayer chip capacitor (ATC 100A-4R3-C-PX-50)
- C7 = 1,8 to 10 pF film dielectric trimmer (cat. no. 2222 809 05002)
- C9 = C12 = 1 nF chip capacitor
- C10 = 100 nF polyester capacitor
- C11 = C13 = 470 nF polyester capacitor
- C14 = 10 nF polyester capacitor
- C15 = 3,3  $\mu\text{F}/40$  F solid aluminium electrolytic capacitor

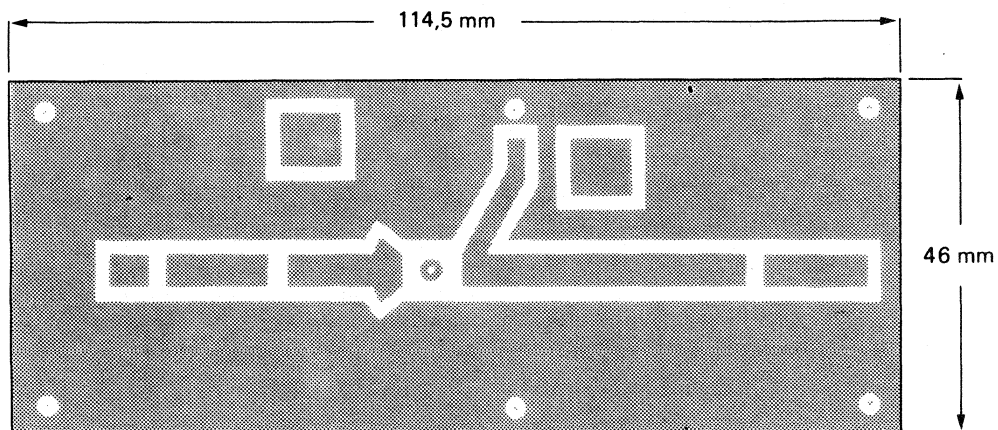
- L1 = stripline (5,2 mm x 4,5 mm)
- L2 = stripline (13,2 mm x 4,5 mm)
- L3 = stripline (15,0 mm x 4,5 mm)
- L4 = micro choke 0,47  $\mu\text{H}$  (cat. no. 4322 057 04770)
- L5 = stripline (see Fig. 9 printed-circuit board layout)
- L6 = 4 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 5,5 mm; leads 2 x 4 mm
- L7 = stripline (37,0 mm x 4,5 mm)
- L8 = stripline (13,5 mm x 4,5 mm)

L1; L2; L3; L5; L7 and L8 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16".

For bias circuit see Fig. 10.



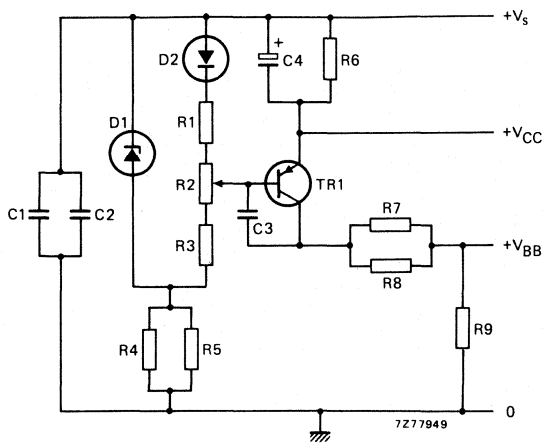
7278880



7278879

Fig. 9 Component layout and printed-circuit board for 860 MHz test circuit.

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.



List of components:

- C1 = 100 pF ceramic capacitor
- C2 = C3 = 100 nF polyester capacitor
- C4 = 10 μF/25 V solid aluminium electrolytic capacitor
- R1 = 150 Ω carbon resistor (0,25 W)
- R2 = 100 Ω preset potentiometer (0,1 W)
- R3 = 82 Ω carbon resistor (0,25 W)
- R4 = R5 = 2,2 kΩ carbon resistor (0,25 W)
- R6 = 6 Ω; parallel connection of 2 x 12 Ω carbon resistors (0,5 W each)
- R7 = R8 = 820 Ω carbon resistor (0,25 W)
- R9 = 33 Ω carbon resistor (0,25 W)
- D1 = BZY88-C3V3
- D2 = BY206
- TR1 = BD136

Fig. 10 Bias circuit for class-A linear amplifier at  $f_{\text{vision}} = 860$  MHz.

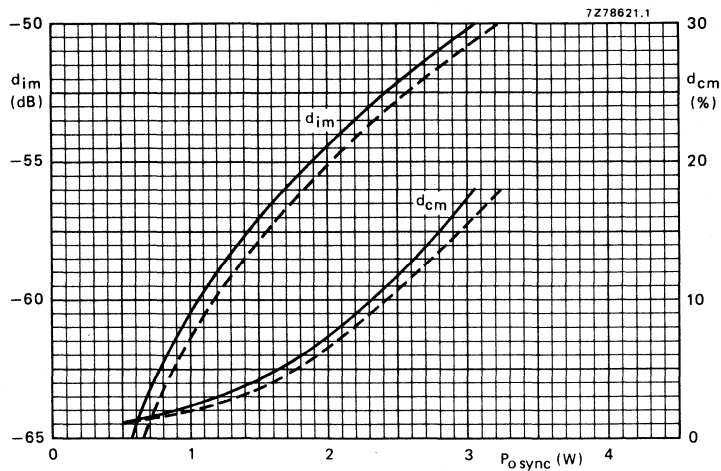


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and cross-modulation distortion ( $d_{cm}$ )\*\* as a function of output power. Typical values;  $V_{CE} = 25$  V;  $I_C = 300$  mA;  $f_{\text{vision}} = 860$  MHz; ---  $T_h = 25$  °C; —  $T_h = 70$  °C.

Information for wideband application from 470 to 860 MHz available on request.

\* Three-tone test method (vision carrier  $-8$  dB, sound carrier  $-7$  dB, sideband signal  $-16$  dB), zero dB corresponds to peak sync level.

Intermodulation distortion of input signal  $\leq -75$  dB.

\*\* Two-tone test method (vision carrier 0 dB, sound carrier  $-7$  dB), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from 0 dB to  $-20$  dB.



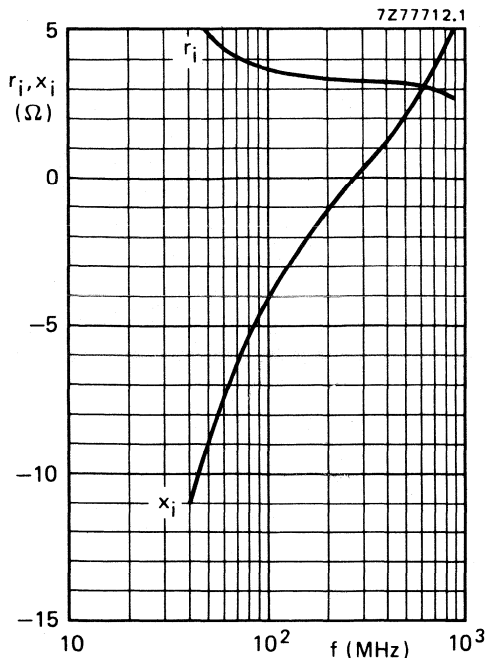


Fig. 12 Input impedance (series components).

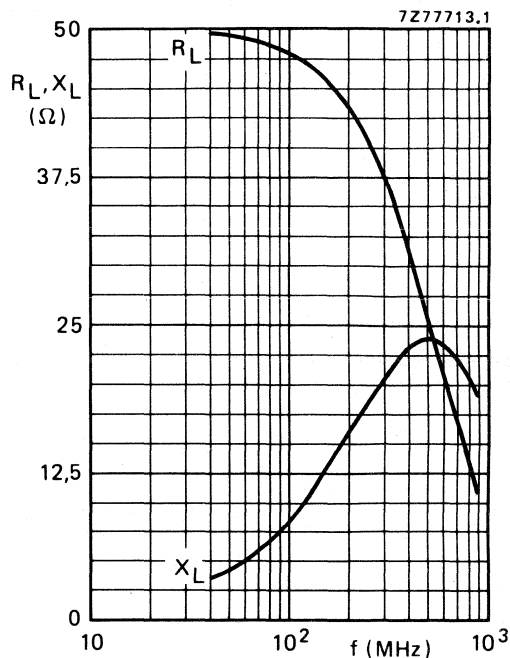


Fig. 13 Load impedance (series components).

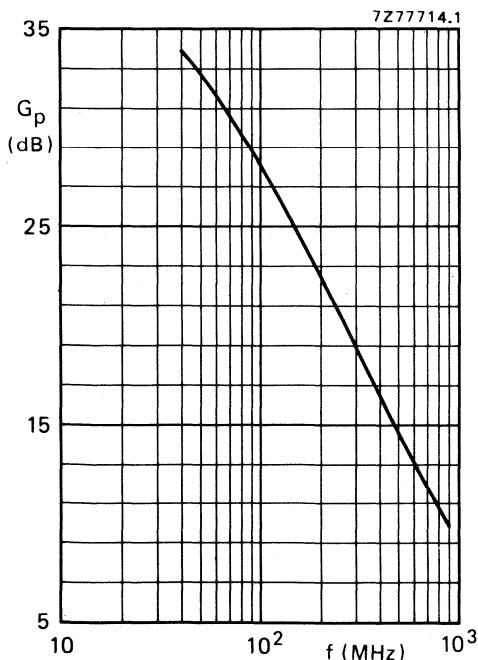


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 25 \text{ V}$ ;  $I_C = 300 \text{ mA}$ ;  
 $T_h = 70 \text{ }^\circ\text{C}$ .

**Ruggedness**

The BLW33 is capable of withstanding a load mismatch (VSWR = 50 through all phases) under the following conditions:

$f = 860 \text{ MHz}$ ;  $V_{CE} = 25 \text{ V}$ ;  $I_C = 300 \text{ mA}$ ;  
 $T_h = 70 \text{ }^\circ\text{C}$  and  $P_L = 2 \text{ W}$ .



## U.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in **linear u.h.f. amplifiers** for television transmitters and transposers. The **excellent d.c. dissipation properties** for class-A operation are obtained by means of diffused emitter ballasting resistors and a multi-base structure, providing an optimum temperature profile on the crystal area. The combination of optimum thermal design and the application of **gold sandwich metallization** realizes excellent reliability properties.

The transistor has a ¼" capstan envelope with ceramic cap.

### QUICK REFERENCE DATA

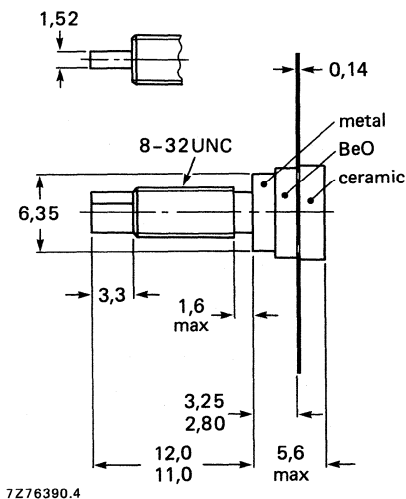
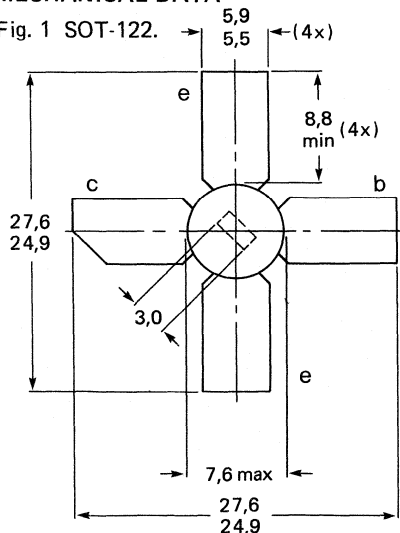
R.F. performance

mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ mA	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{O sync}}^*$ W	$G_{\text{p}}$ dB
class-A; linear amplifier	860	25	600	70	-60	> 1,8	> 9
	860	25	600	25	-60	typ. 2,15	typ. 10,2

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

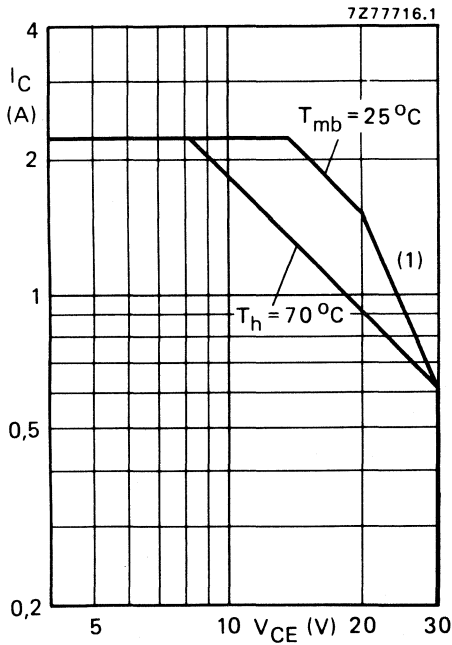
When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak value); $V_{BE} = 0$	$V_{CESM}$	max.	50 V
open base	$V_{CEO}$	max.	30 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average	$I_C$	max.	2,25 A
(peak value); $f > 1$ MHz	$I_{CM}$	max.	3,5 A
Total power dissipation at $T_{mb} = 25$ °C	$P_{tot}$	max.	31 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

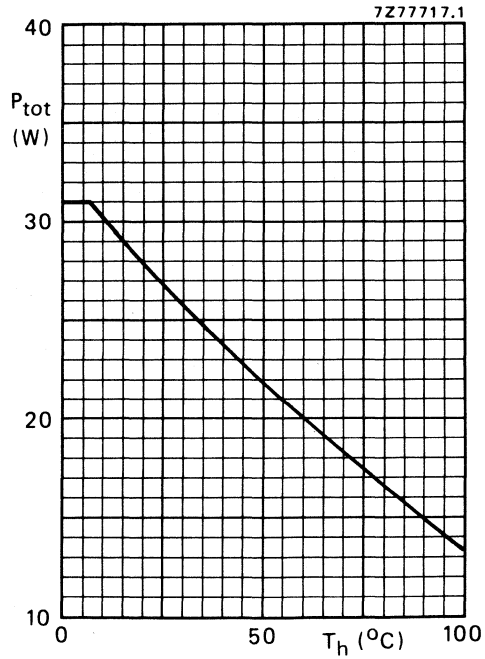


Fig. 3 Power derating curve vs. temperature.

**THERMAL RESISTANCE** (see Fig. 4)

From junction to mounting base  
(dissipation = 15 W;  $T_{mb} = 79$  °C; i.e.  $T_h = 70$  °C)

$R_{th\ j-mb} = 6,2\ K/W$

From mounting base to heatsink

$R_{th\ mb-h} = 0,6\ K/W$

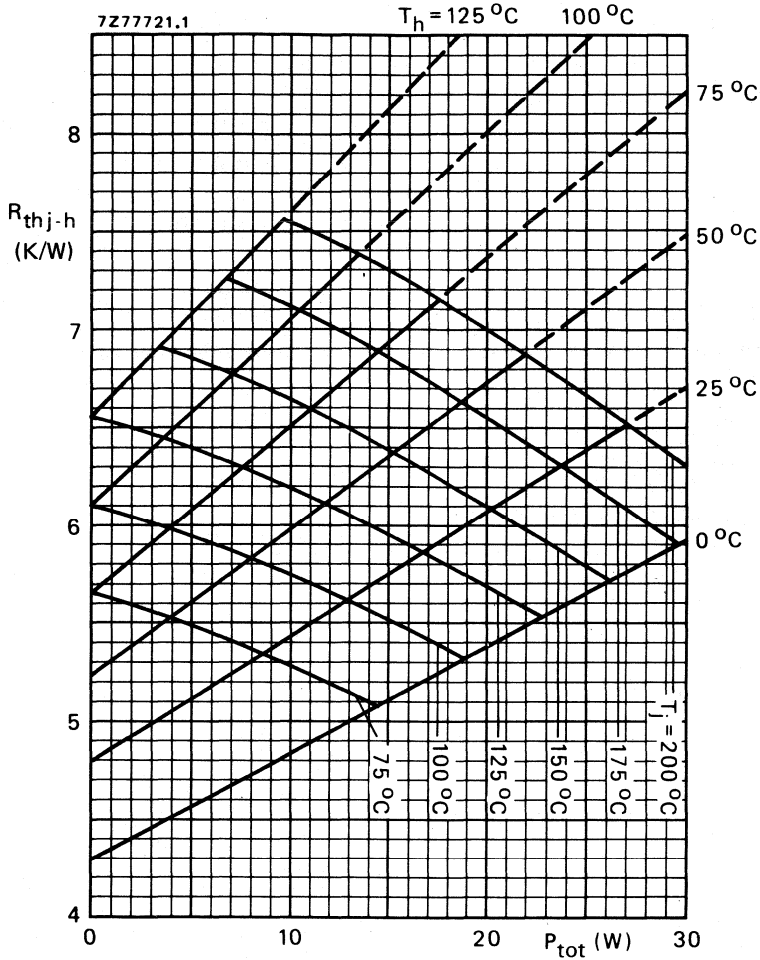


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{thmb-h} = 0,6$  K/W.)

**Example**

Nominal class-A operation:  $V_{CE} = 25$  V;  $I_C = 600$  mA;  $T_h = 70^\circ\text{C}$ .

Fig. 4 shows:  $R_{thj-h}$  max. 6,75 K/W  
 $T_j$  max.  $170^\circ\text{C}$

Typical device:  $R_{thj-h}$  typ. 5,45 K/W  
 $T_j$  typ.  $152^\circ\text{C}$

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$V_{BE} = 0$ ;  $I_C = 8\text{ mA}$

$V_{(BR)CES} > 50\text{ V}$

open base;  $I_C = 60\text{ mA}$

$V_{(BR)CEO} > 30\text{ V}$

Emitter-base breakdown voltage

open collector;  $I_E = 4\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0$ ;  $V_{CE} = 30\text{ V}$

$I_{CES} < 2,0\text{ mA}$

$V_{BE} = 0$ ;  $V_{CE} = 30\text{ V}$ ;  $T_j = 175\text{ }^\circ\text{C}$

$I_{CES} < 5,0\text{ mA}$

D.C. current gain

$I_C = 600\text{ mA}$ ;  $V_{CE} = 25\text{ V}$

$h_{FE} > 20$   
typ. 40

$I_C = 600\text{ mA}$ ;  $V_{CE} = 25\text{ V}$ ;  $T_j = 175\text{ }^\circ\text{C}$

$h_{FE} < 120$

Collector-emitter saturation voltage \*

$I_C = 1,2\text{ A}$ ;  $I_B = 0,12\text{ A}$

$V_{CEsat}$  typ. 450 mV

Transition frequency at  $f = 500\text{ MHz}$  \*\*

$-I_E = 0,6\text{ A}$ ;  $V_{CB} = 25\text{ V}$

$f_T$  typ. 3,3 GHz

$-I_E = 1,2\text{ A}$ ;  $V_{CB} = 25\text{ V}$

$f_T$  typ. 3,0 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0$ ;  $V_{CB} = 25\text{ V}$

$C_C$  typ. 13,5 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 40\text{ mA}$ ;  $V_{CE} = 25\text{ V}$

$C_{re}$  typ. 8,4 pF

Collector-stud capacitance

$C_{cs}$  typ. 1,2 pF

\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}$ ;  $\delta \leq 0,02$ .

\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}$ ;  $\delta \leq 0,01$ .

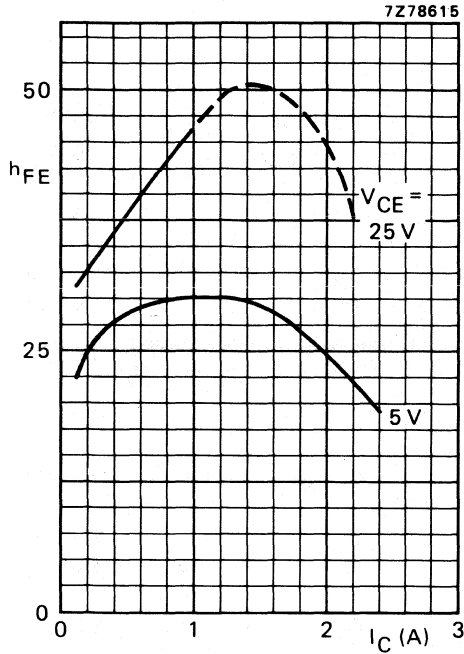


Fig. 5 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

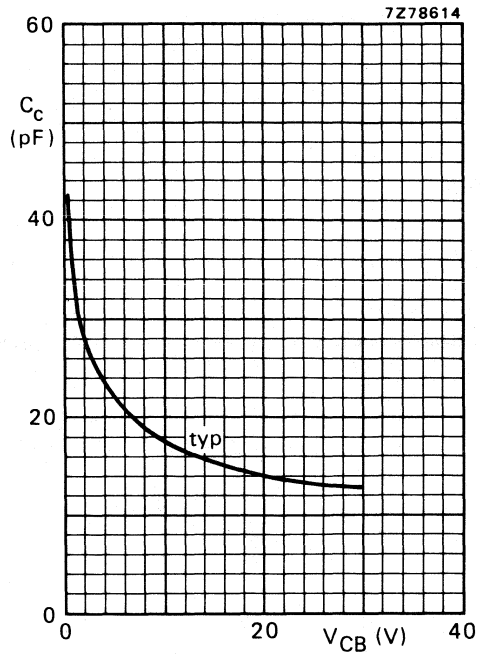


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

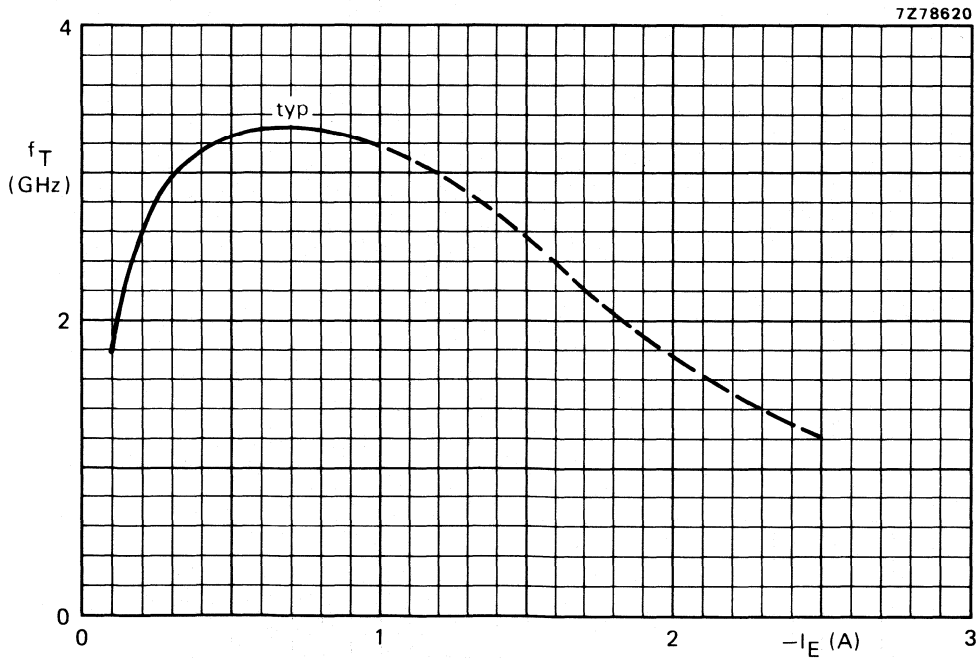


Fig. 7  $V_{CB} = 25\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$

## APPLICATION INFORMATION

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (mA)	$T_{\text{h}}$ ( $^{\circ}\text{C}$ )	$d_{\text{im}}$ (dB) *	$P_{\text{O sync}}$ (W) *	$G_{\text{p}}$ (dB)
860	25	600	70	-60	> 1,8	> 9
860	25	600	70	-60	typ. 1,9	typ. 10,2
860	25	600	25	-60	typ. 2,15	typ. 10,2

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

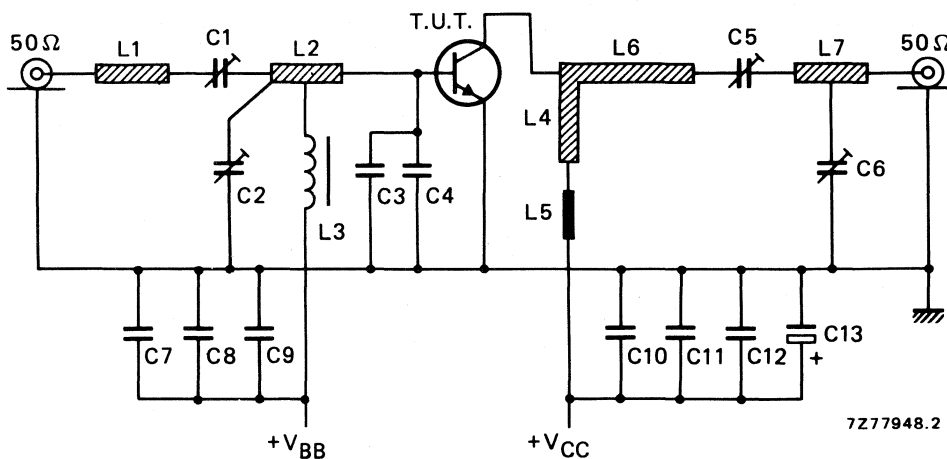


Fig. 8 Test circuit at  $f_{\text{vision}} = 860$  MHz.

List of components:

C1 = C5 = 1,8 to 10 pF film dielectric trimmer (cat. no. 2222 809 05002)

C2 = C6 = 1 to 3,5 pF film dielectric trimmer (cat. no. 2222 809 05001) placed 13,5 mm and 46 mm respectively from transistor edge

C3 = C4 = 2 pF multilayer chip capacitor (ATC 100A-2RO-C-PX-50)

C7 = C10 = 1 nF chip capacitor

C8 = 100 nF polyester capacitor

C9 = C12 = 470 nF polyester capacitor

C11 = 10 nF polyester capacitor

C13 = 3,3  $\mu\text{F}/40$  V solid aluminium electrolytic capacitor

L1 = stripline (9,2 mm x 7,0 mm)

L2 = stripline (14,2 mm x 7,0 mm)

L3 = micro choke 0,47  $\mu\text{H}$  (cat. no. 4322 057 04770)

L4 = stripline (see Fig. 9 printed-circuit board layout)

L5 = 34 mm straight Cu wire (1,0 mm); height above print 3,3 mm

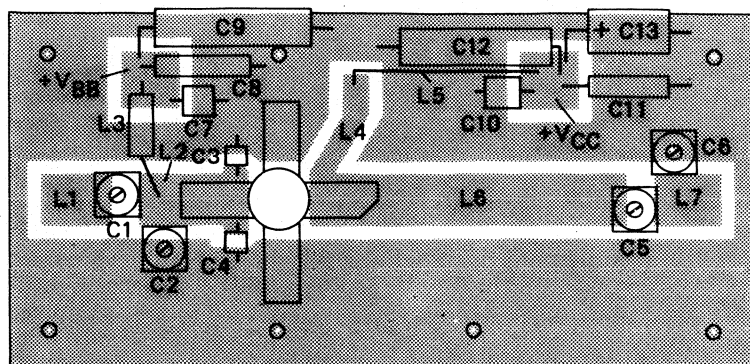
L6 = stripline (41,0 mm x 7,0 mm)

L7 = stripline (8,7 mm x 7,0 mm)

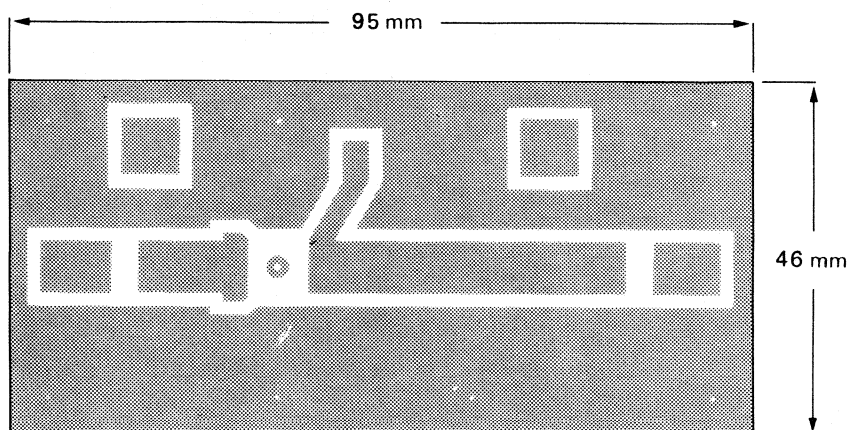
L1; L2; L4; L6 and L7 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16".

Component layout and printed-circuit board for 860 MHz test circuit are shown in Fig. 9. For bias circuit see Fig. 10.





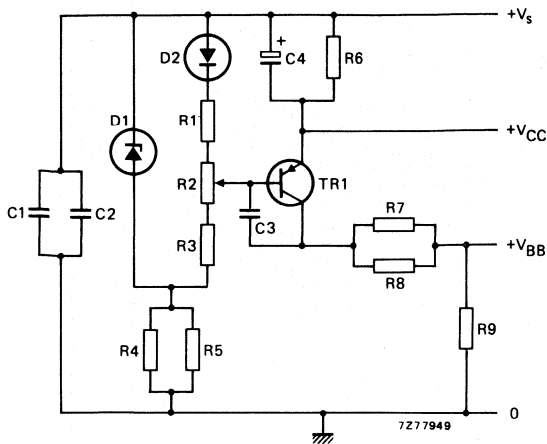
7Z78882



7Z78877

Fig. 9 Component layout and printed-circuit board for 860 MHz test circuit.

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.



List of components:

- C1 = 100 pF ceramic capacitor
- C2 = C3 = 100 nF polyester capacitor
- C4 = 10 μF/25 V solid aluminium electrolytic capacitor
- R1 = 150 Ω carbon resistor (0,25 W)
- R2 = 100 Ω preset potentiometer (0,1 W)
- R3 = 82 Ω carbon resistor (0,25 W)
- R4 = R5 = 2,2 kΩ carbon resistor (0,25 W)
- R6 = 2,8 Ω; parallel connection of 2 x 5,6 Ω carbon resistors (0,5 W each)
- R7 = R8 = 820 Ω carbon resistor (0,25 W)
- R9 = 33 Ω carbon resistor (0,25 W)
- D1 = BZY88-C3V3
- D2 = BY206
- TR1 = BD136

Fig. 10 Bias circuit for class-A linear amplifier at  $f_{\text{vision}} = 860 \text{ MHz}$ .

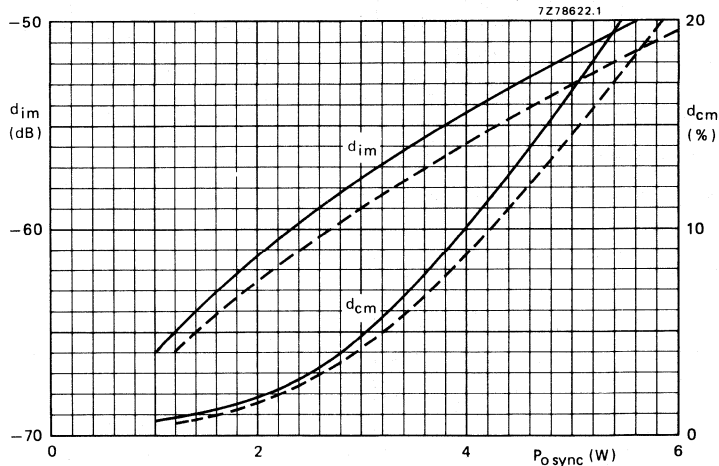


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and cross-modulation distortion ( $d_{cm}$ )\*\* as a function of output power. Typical values;  $V_{CE} = 25 \text{ V}$ ;  $I_C = 600 \text{ mA}$ ;  $f_{\text{vision}} = 860 \text{ MHz}$ ; ---  $T_h = 25 \text{ }^\circ\text{C}$ ; —  $T_h = 70 \text{ }^\circ\text{C}$ .

Information for wideband application from 470 to 860 MHz available on request.

\* Three-tone test method (vision carrier  $-8 \text{ dB}$ , sound carrier  $-7 \text{ dB}$ , sideband signal  $-16 \text{ dB}$ ), zero dB corresponds to peak sync level.  
Intermodulation distortion of input signal  $\leq -75 \text{ dB}$ .

\*\* Two-tone test method (vision carrier  $0 \text{ dB}$ , sound carrier  $-7 \text{ dB}$ ), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from  $0 \text{ dB}$  to  $-20 \text{ dB}$ .

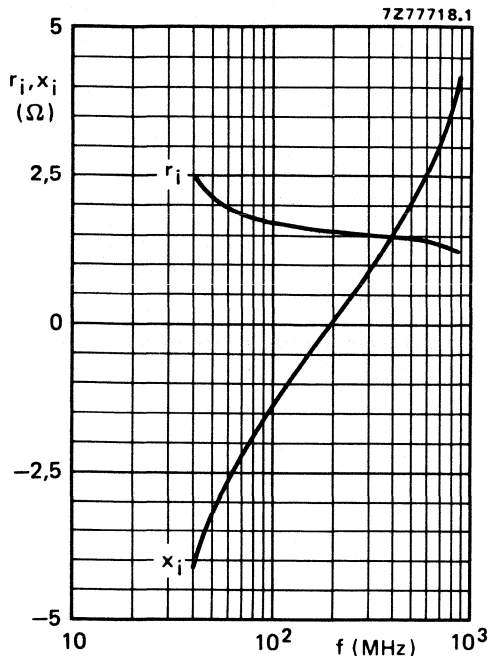


Fig. 12 Input impedance (series components).

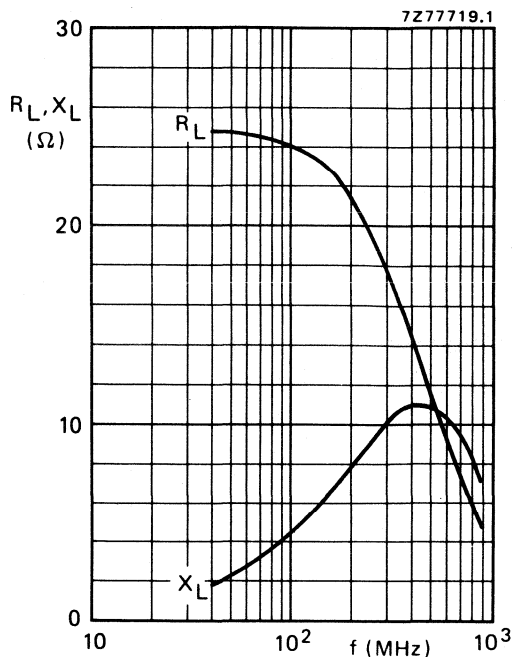


Fig. 13 Load impedance (series components).

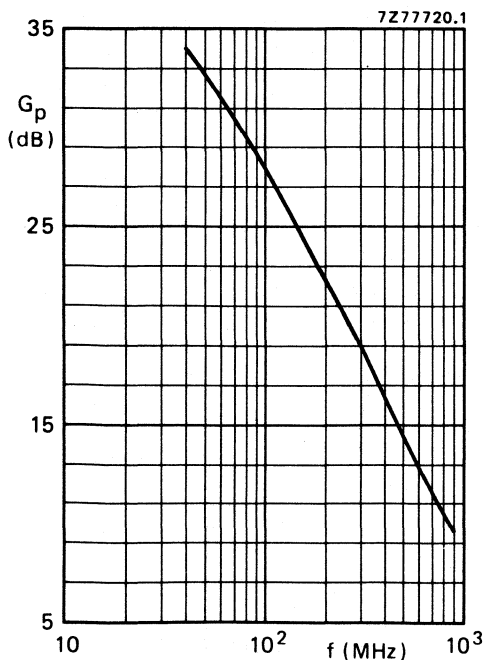


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 25$  V;  $I_C = 600$  mA;  
 $T_h = 70$  °C.

**Ruggedness**

The BLW34 is capable of withstanding a load mismatch (VSWR = 50 through all phases) under the following conditions:

$f = 860$  MHz;  $V_{CE} = 25$  V;  $I_C = 600$  mA;  
 $T_h = 70$  °C and  $P_L = 4$  W.



## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in class-A, AB and B operated, industrial and military transmitters in the h.f. and v.h.f. band. Resistance stabilization provides protection against device damage at severe load mismatch conditions. Matched  $h_{FE}$  groups are available on request.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance

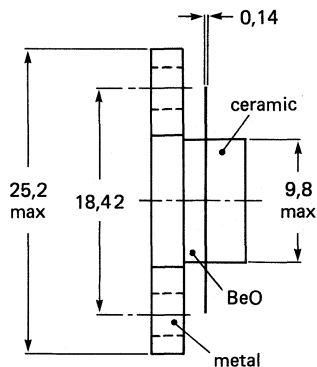
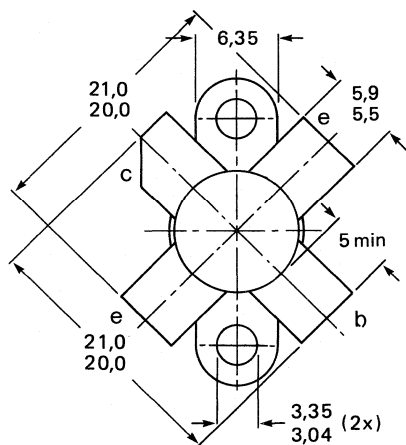
mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_{dt}$ %	$I_C$ A	$I_C(ZS)$ mA	$d_3$ dB	$T_h$ °C
s.s.b. (class-A)	45	1,6 - 28	0 - 16 (P.E.P.)	> 19,5	—	1,2	—	< -40	70
s.s.b. (class-AB)	50	1,6 - 28	10 - 65 (P.E.P.)	typ. 18	typ. 45*	1,45	50	typ. -30	25

\* At 65W P.E.P.

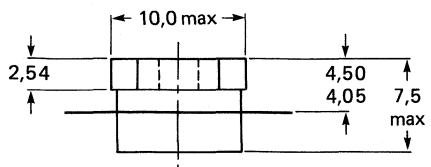
### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.



7277386.2



Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value

$V_{CESM}$  max. 110 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 55 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_C(AV)$  max. 2,5 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 7,5 A

D.C. and r.f. ( $f > 1$  MHz) power dissipation;  $T_{mb} = 25$  °C

$P_{tot}; P_{rf}$  max. 94 W

Storage temperature

$T_{stg}$  -65 to +150 °C

Operating junction temperature

$T_j$  max. 200 °C

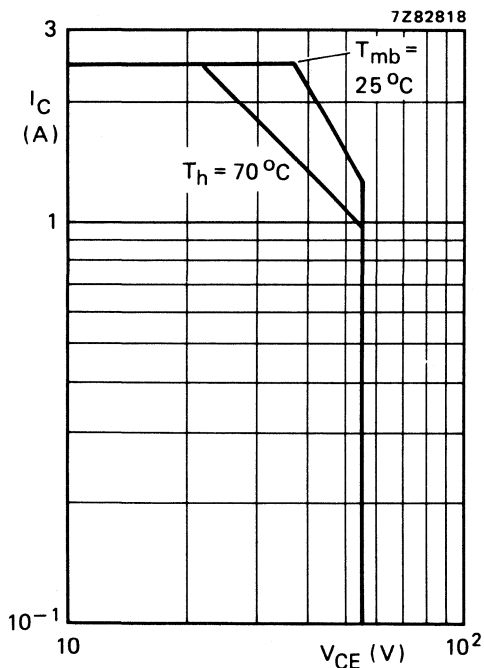


Fig. 2 D.C. SOAR.

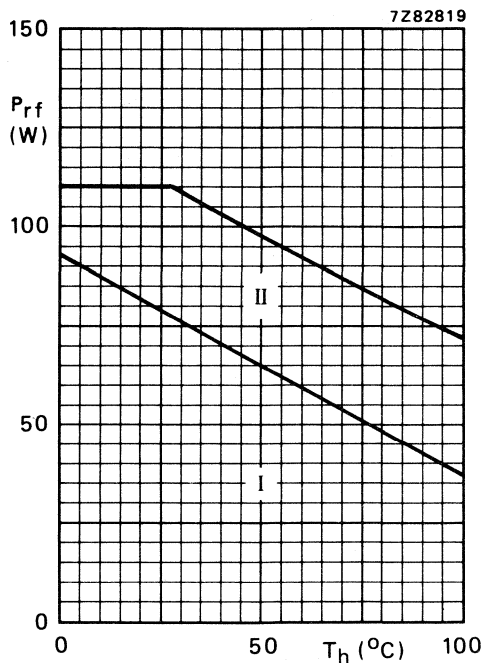


Fig. 3 Power derating curves vs. temperature.  
I Continuous d.c. and r.f. operation  
II Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 54 W;  $T_{mb} = 86$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base  
(d.c. and r.f. dissipation)

$R_{th j-mb} = 2,1$  K/W

From mounting base to heatsink

$R_{th mb-h} = 0,3$  K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 25\text{ mA}$  $V_{(BR)CES} > 110\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 100\text{ mA}$  $V_{(BR)CEO} > 55\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 55\text{ V}$  $I_{CES} < 10\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\text{ }\Omega$  $ES_{BO} > 8\text{ mJ}$  $ES_{BR} > 8\text{ mJ}$ 

D.C. current gain\*

 $I_C = 1,2\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 25  
15 to 100

D.C. current gain ratio of matched devices\*

 $I_C = 1,2\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE1}/h_{FE2} < 1,2$ 

Collector-emitter saturation voltage\*

 $I_C = 3,0\text{ A}; I_B = 0,6\text{ A}$  $V_{CEsat}$  typ. 1,2 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 1,2\text{ A}; V_{CB} = 45\text{ V}$  $-I_E = 4,0\text{ A}; V_{CB} = 45\text{ V}$  $f_T$  typ. 490 MHz $f_T$  typ. 540 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 45\text{ V}$  $C_c$  typ. 53 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 50\text{ mA}; V_{CE} = 45\text{ V}$  $C_{re}$  typ. 35 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

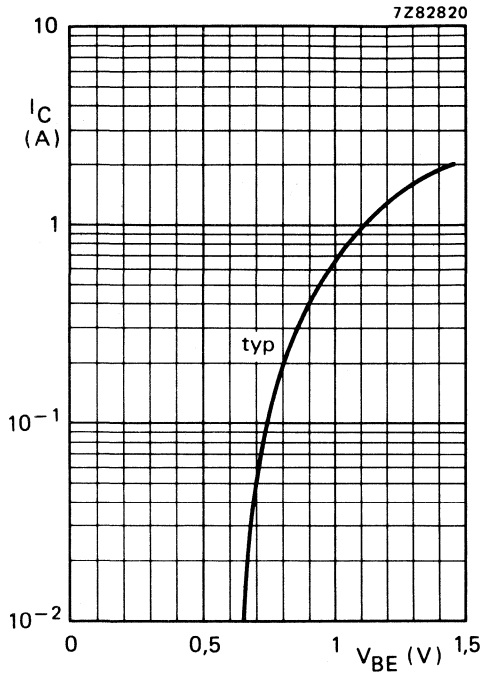


Fig. 4  $V_{CE} = 40$  V;  $T_{mb} = 25$  °C.

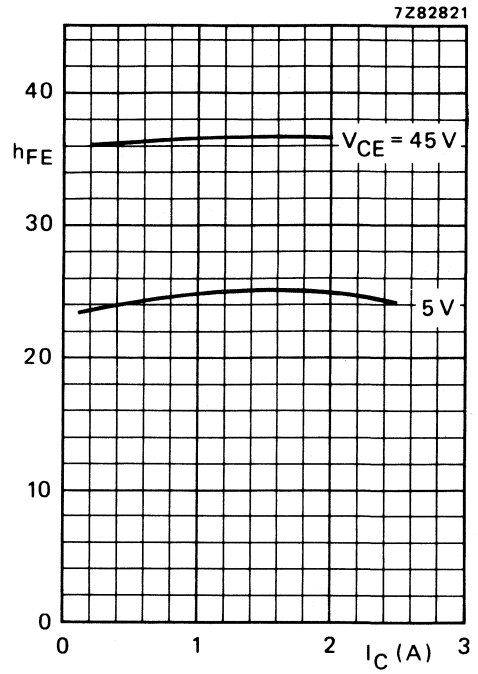


Fig. 5 Typical values;  $T_j = 25$  °C.

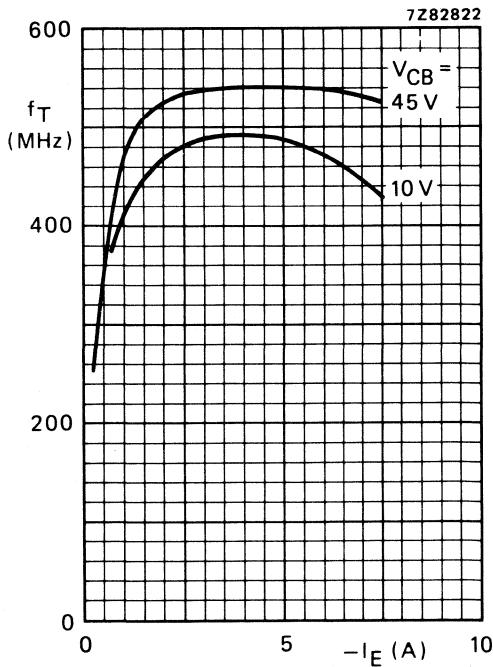


Fig. 6 Typical values;  $f = 100$  MHz;  $T_j = 25$  °C.

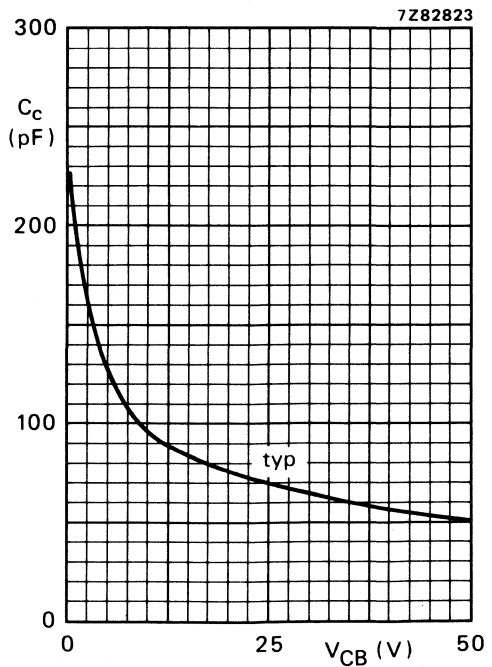


Fig. 7  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.



## APPLICATION INFORMATION

R.F. performance in s.s.b. class-A operation (linear power amplifier)

 $V_{CE} = 45 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$I_C$ A	$d_3^*$ dB	$d_5^*$ dB	$T_h$ $^{\circ}\text{C}$
> 16 (P.E.P.)	> 19,5	1,2	-40	< -40	70
typ. 17 (P.E.P.)	typ. 20,5	1,2	-40	< -40	70

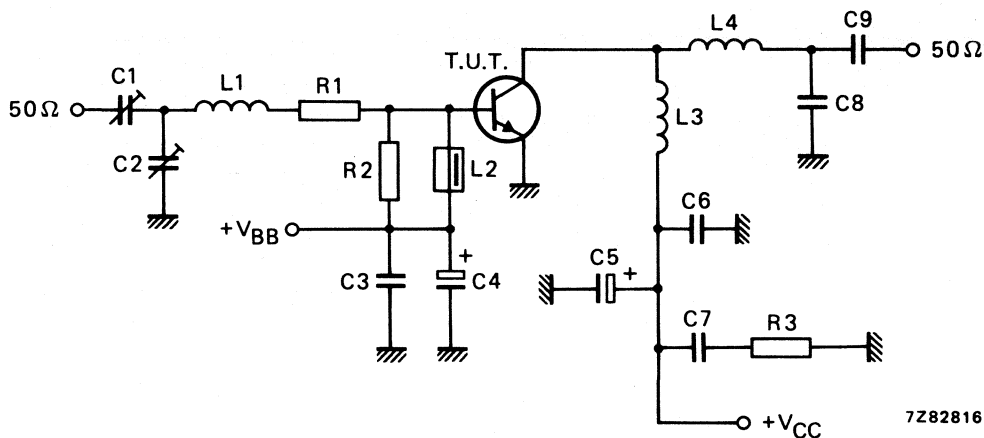


Fig. 8 Test circuit; s.s.b. class-A.

List of components in Fig. 8:

C1 = C2 = 10 to 780 pF film dielectric trimmer

C3 = 22 nF ceramic capacitor (63 V)

C4 = 4,7  $\mu\text{F}$ /16 V electrolytic capacitorC5 = 1  $\mu\text{F}$ /75 V solid tantalum capacitor

C6 = C7 = 47 nF polyester capacitor (100 V)

C8 = 68 pF ceramic capacitor (500 V)

C9 = 3,9 nF ceramic capacitor

L1 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 1,05  $\mu\text{H}$ ; 15 turns enamelled Cu wire (1,0 mm); int. dia. 10,0 mm; length 17,4 mm; leads 2 x 5 mm

L4 = 162 nH; 6 turns enamelled Cu wire (1,0 mm); int. dia. 7,0 mm; length 11,6 mm; leads 2 x 5 mm

R1 = 1,6  $\Omega$ ; parallel connection of 3 x 4,7  $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,125 W)R2 = 47  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,25 W)R3 = 4,7  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,25 W)

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

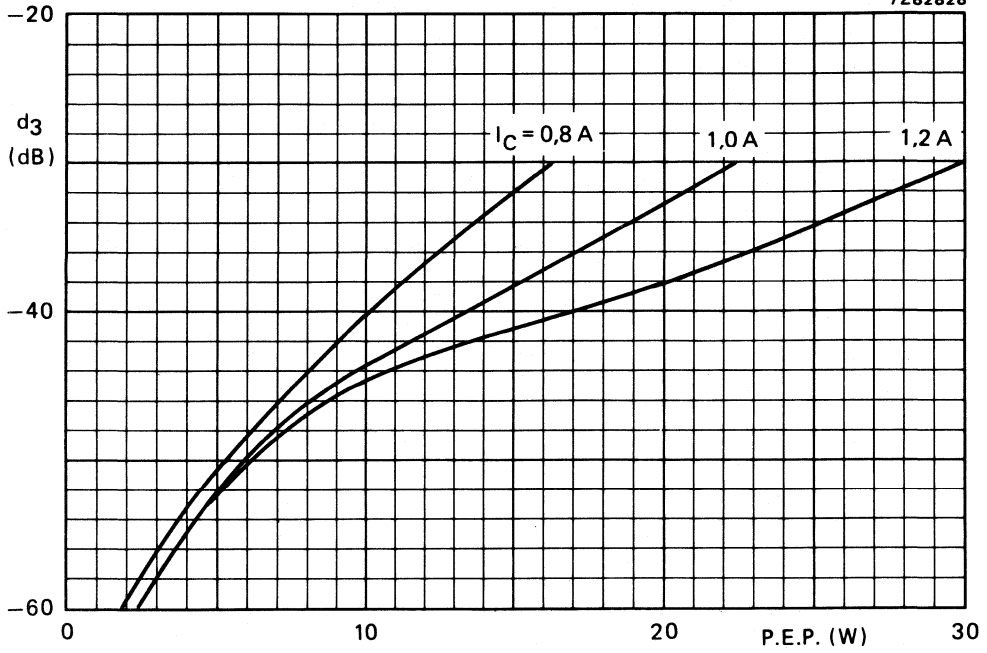


Fig. 9 Intermodulation distortion (see note on page 5) as a function of output power. Typical values;  $V_{CE} = 45\text{ V}$ ;  $f_1 = 28,000\text{ MHz}$ ;  $f_2 = 28,001\text{ MHz}$ ;  $T_h = 70\text{ }^\circ\text{C}$ .

R.F. performance in s.s.b. class-AB operation (linear power amplifier)

$V_{CE} = 50 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$\eta_{dt}$ (%) at 65 W P.E.P.	$I_C$ (A)	$d_3^*$ dB	$d_5^*$ dB	$I_C(ZS)$ mA	$T_h$ $^{\circ}\text{C}$
10 to 65 (P.E.P.)	typ. 18	typ. 45	typ. 1,45	typ. -30	< -30	50	25

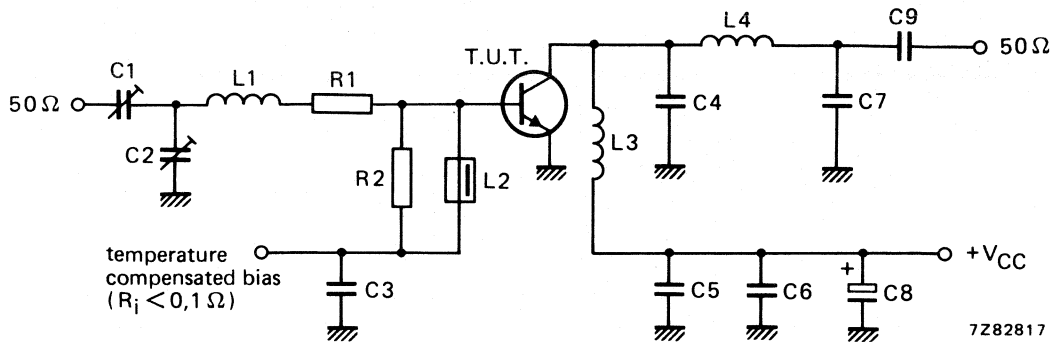


Fig. 10 Test circuit; s.s.b. class-AB.

List of components:

C1 = C2 = 10 to 780 pF film dielectric trimmer

C3 = C5 = C6 = 220 nF polyester capacitor

C4 = 120 pF ceramic capacitor (500 V)

C7 = 150 pF ceramic capacitor (500 V)

C8 = 47  $\mu\text{F}$ /63 V electrolytic capacitor

C9 = 3,9 nF ceramic capacitor

L1 = 4 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 7,0 mm; leads 2 x 5 mm

L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 9 turns enamelled Cu wire (1,0 mm); int. dia. 10 mm; length 14,5 mm; leads 2 x 5 mm

L4 = 6 turns enamelled Cu wire (1,0 mm); int. dia. 6,5 mm; length 11,0 mm; leads 2 x 5 mm

R1 = 2,4  $\Omega$ ; parallel connection of 2 x 4,7  $\Omega$  carbon resistors

R2 = 39  $\Omega$  carbon resistor

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

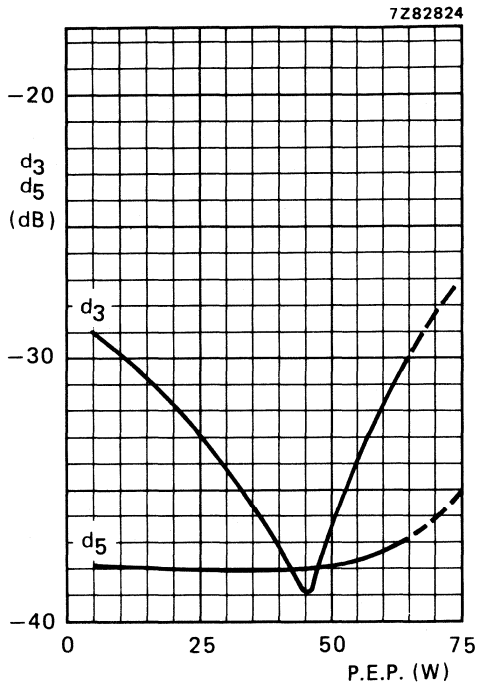


Fig. 11 Intermodulation distortion as a function of output power\*.

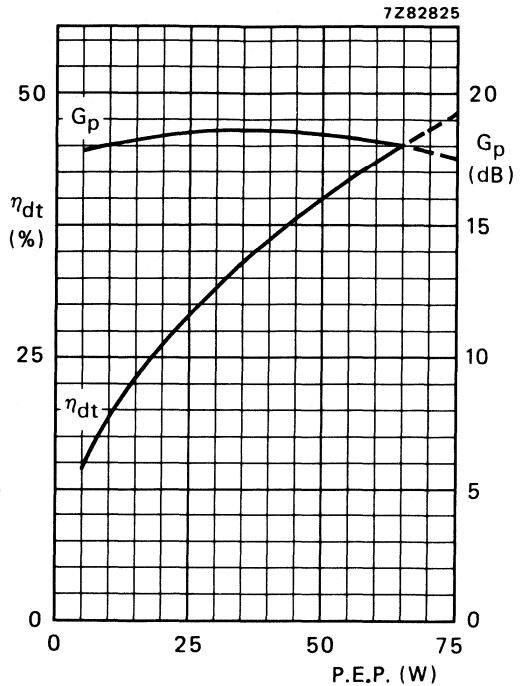


Fig. 12 Double-tone efficiency and power gain as a function of output power.

Conditions for Figs 11 and 12:

$V_{CE} = 50 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; typical values.

**Ruggedness in s.s.b. operation**

The BLW50F is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 45 W (P.E.P.) under the following conditions:

$V_{CE} = 50 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,3 \text{ K/W}$ .

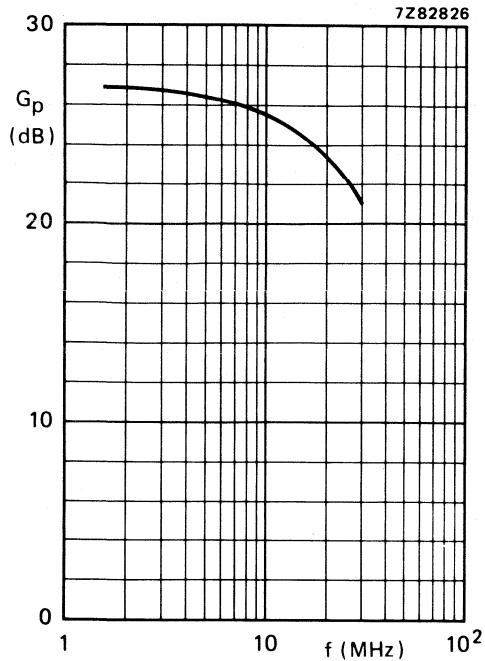


Fig. 13 Power gain as a function of frequency.

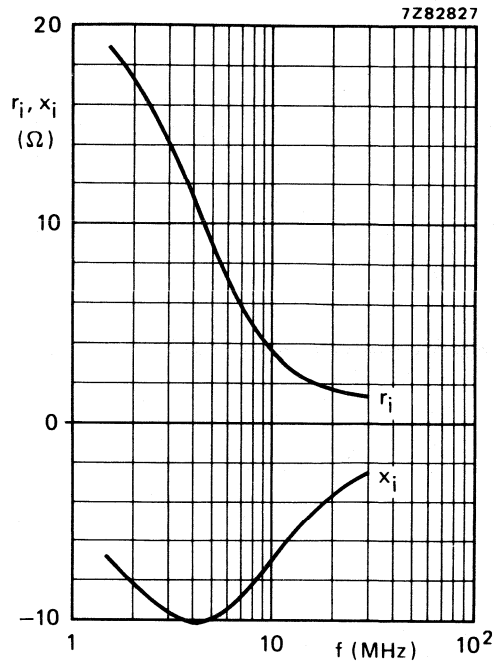


Fig. 14 Input impedance (series components) as a function of frequency.

Figs 13 and 14 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

Conditions for Figs 13 and 14:

$V_{CE} = 50 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $P_L = 60 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 16 \text{ } \Omega$ .



### V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a nominal supply voltage of 12,5 V. The transistor is resistance stabilized. Every transistor is tested under severe load mismatch conditions with a supply over-voltage to 15 V. Matched  $h_{FE}$  groups are available on request.

It has a plastic encapsulated stripline package. All leads are isolated from the stud.

#### QUICK REFERENCE DATA

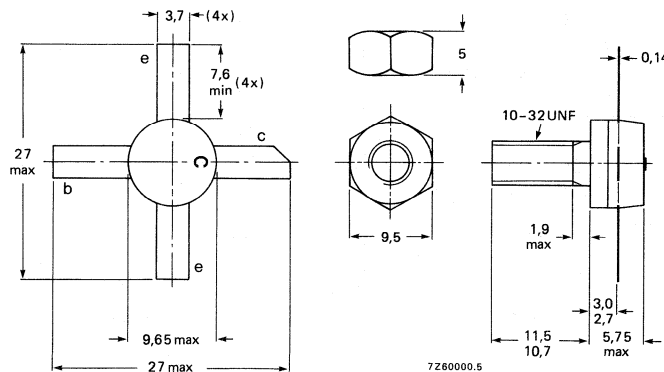
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Z}_L$ $\Omega$	$d_3$ dB
c.w. (class-B)	12,5	175	45	> 5,0	> 75	1,2 + j1,4	2,6 - j1,2	—
s.s.b. (class-AB)	12,5	1,6-28	3-30 (P.E.P.)	typ. 19,5	typ. 35	—	—	typ. -33

#### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-56.



When locking is required an adhesive is preferred instead of a lock washer.

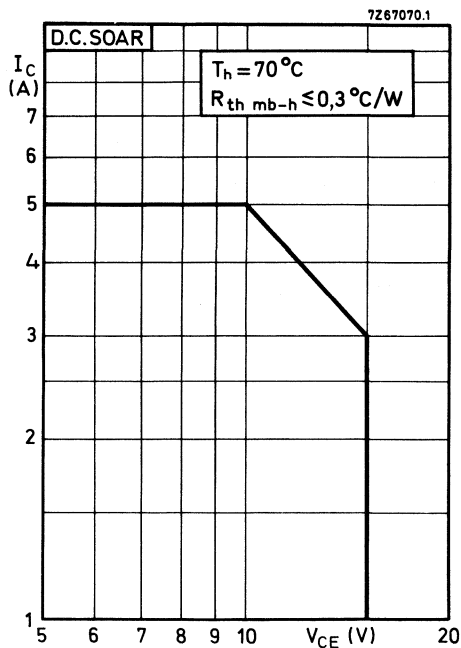
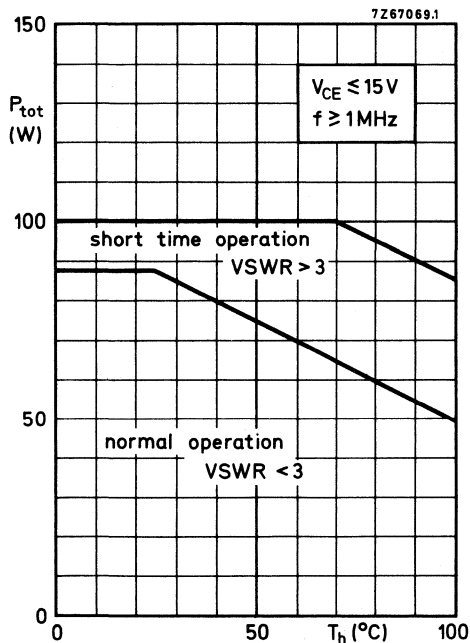
Torque on nut: min. 1,5 Nm  
(15 kg cm)  
max. 1,7 Nm  
(17 kg cm)

Diameter of clearance hole in heatsink: max. 4,9 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	8 A
Collector current (peak value); $f \geq 1\text{MHz}$	$I_{CM}$	max.	20 A
Total power dissipation at $T_h = 70^\circ\text{C}$ $f \geq 1\text{ MHz}; V_{CE} \leq 15\text{ V}; R_{th\text{ mb-h}} \leq 0,3\text{ K/W}$ Derate by 0,5 W/K for $50^\circ\text{C} \leq T_h \leq 100^\circ\text{C}$			
	$P_{tot}$	max.	65 W



Storage temperature

$T_{stg}$  -65 to +200  $^\circ\text{C}$



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage  
open emitter;  $I_C = 100\text{ mA}$   $V_{(BR)CBO} > 36\text{ V}$

Collector-emitter voltage  
open base;  $I_C = 100\text{ mA}$   $V_{(BR)CEO} > 18\text{ V}$

Emitter-base voltage  
open collector;  $I_E = 25\text{ mA}$   $V_{(BR)EBO} > 4\text{ V}$

## Transient energy

 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ 

open base  $E > 8\text{ ms}$   
 $-V_{BE} = 1,5\text{ V}$ ;  $R_{BE} = 33\text{ }\Omega$   $E > 8\text{ ms}$

## D.C. current gain

$I_C = 1\text{ A}$ ;  $V_{CE} = 5\text{ V}$   $h_{FE} 20\text{ to }100$

## D.C. current gain ratio of matched devices

$I_C = 1\text{ A}$ ;  $V_{CE} = 5\text{ V}$   $h_{FE1}/h_{FE2} < 1,2$

## Transition frequency

$I_C = 6\text{ A}$ ;  $V_{CE} = 10\text{ V}$   $f_T$  typ.  $550\text{ MHz}$

Collector capacitance at  $f = 1\text{ MHz}$ 

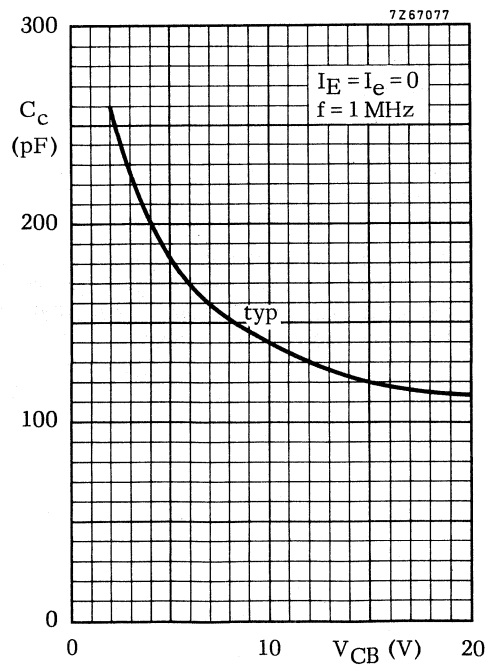
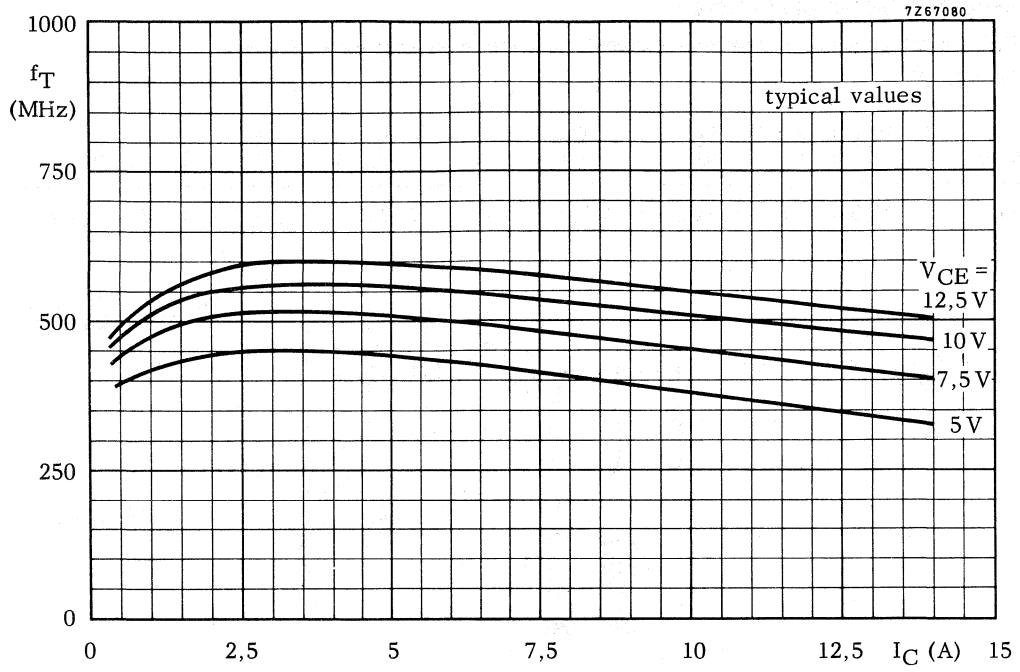
$I_E = I_e = 0$ ;  $V_{CB} = 15\text{ V}$   $C_c$  typ.  $120\text{ pF}$   
 $< 160\text{ pF}$

## Feedback capacitance

$I_C = 200\text{ mA}$ ;  $V_{CE} = 15\text{ V}$   $C_{re}$  typ.  $80\text{ pF}$

## Collector-stud capacitance

$C_{cs}$  typ.  $2\text{ pF}$



## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f MHz	$V_{CE}$ V	$P_L$ W	$P_S$ W	$G_p$ dB	$I_C$ A	$\eta$ %	$\bar{Z}_j$ $\Omega$	$\bar{Z}_L$ $\Omega$
175	12,5	45	< 14,2	> 5,0	< 4,8	> 75	$1,2 + j1,4$	$2,6 - j1,2$

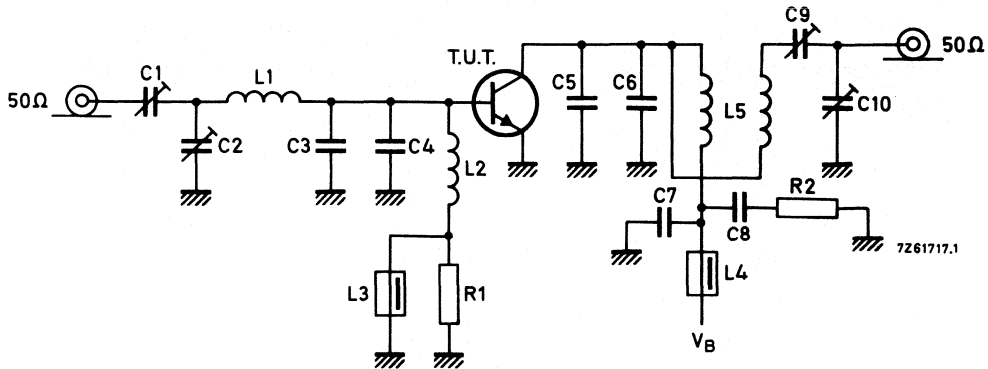


Fig. 6 Test circuit; c.w. class-B.

List of components:

C1 = 2 to 20 pF film dielectric trimmer

C2 = 4 to 40 pF film dielectric trimmer

C3 = C4 = C5 = C6 = 56 pF ceramic capacitor

C7 = 100 pF ceramic capacitor

C8 = 100 nF polyester capacitor

C9 = 4 to 80 pF film dielectric trimmer

C10 = 4 to 60 pF film dielectric trimmer

L1 = 1½ turns enamelled Cu wire (1,6 mm); int. dia. 6,0 mm; length 4 mm; leads 2 x 5 mm

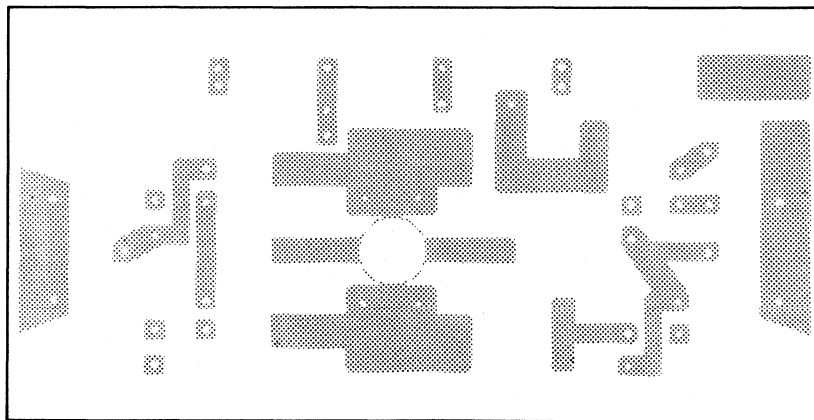
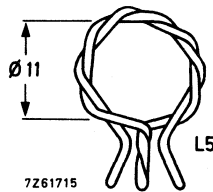
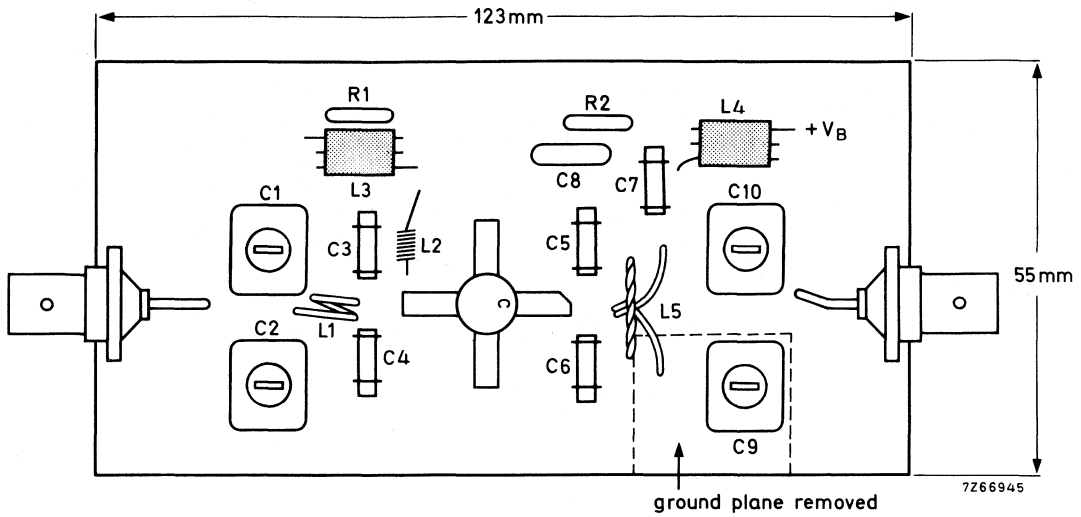
L2 = 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3,0 mm; leads 2 x 5 mm

L3 = L4 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L5 = bifilar wound enamelled Cu wire (1,0 mm); see figure on

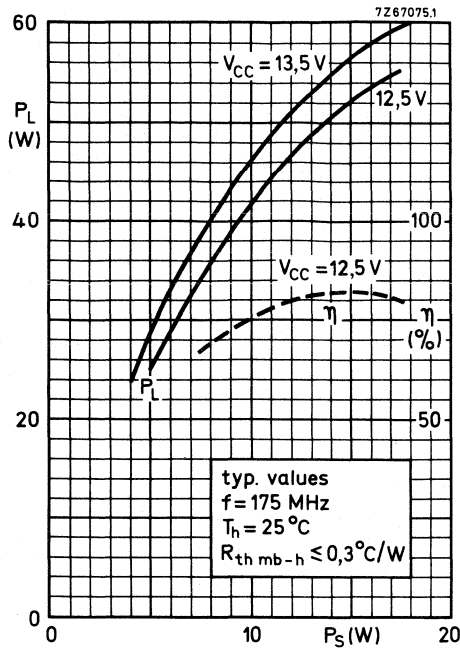
R1 = 10  $\Omega$  carbon resistorR2 = 4,7  $\Omega$  carbon resistor

APPLICATION INFORMATION (continued)

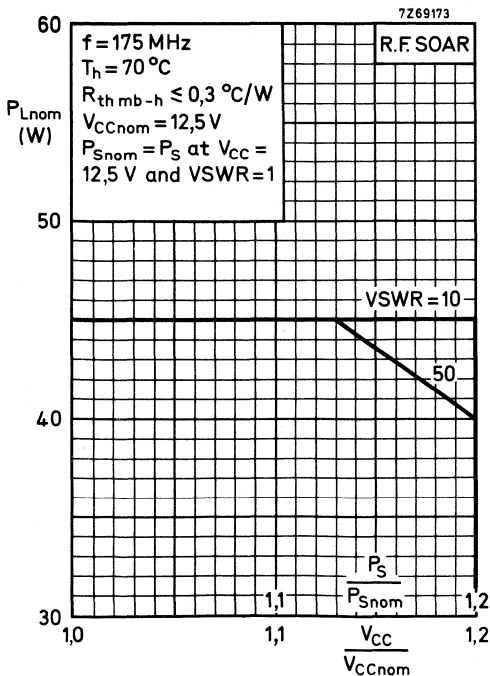


7Z66943

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.



At  $P_L = 45 \text{ W}$  and  $V_{CC} = 12,5 \text{ V}$ , the output power at heatsink temperatures between  $25^\circ C$  and  $70^\circ C$  relative to that at  $25^\circ C$  is diminished by  $60 \text{ mW/K}$



The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power ( $P_{Lnom}$ ) must be derated in accordance with the adjacent graph for safe operation at supply voltages other than nominal. The graph shows the allowable output power under nominal conditions as a function of the supply overvoltage ratio with VSWR as parameter. The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply overvoltage ratio ( $V_{CC}/V_{CCnom}$ ).

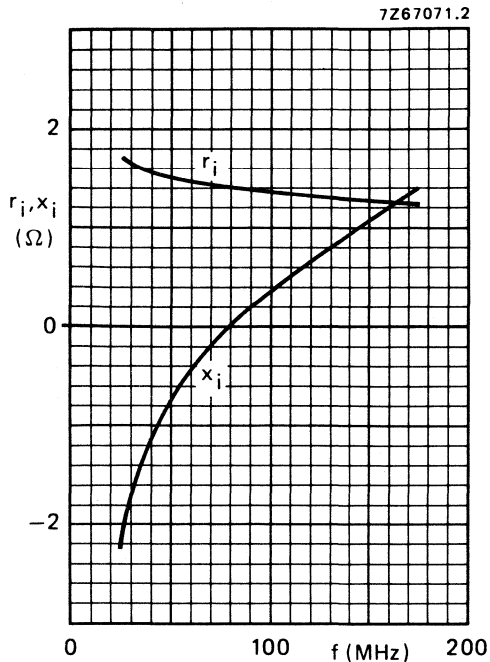


Fig. 10 Input impedance (series components).

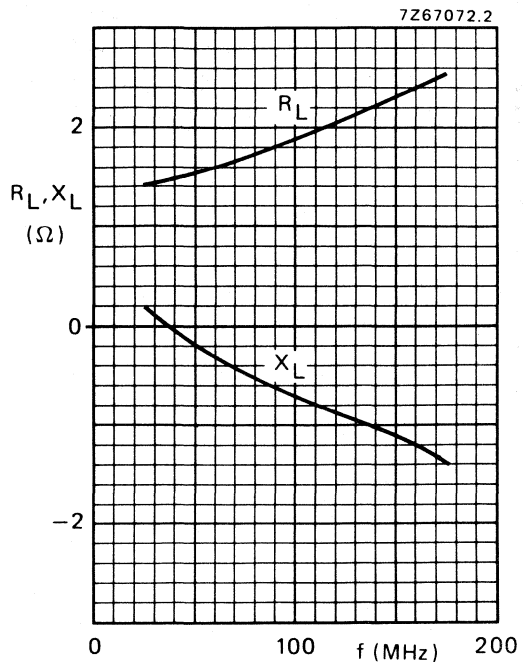


Fig. 11 Load impedance (series components).

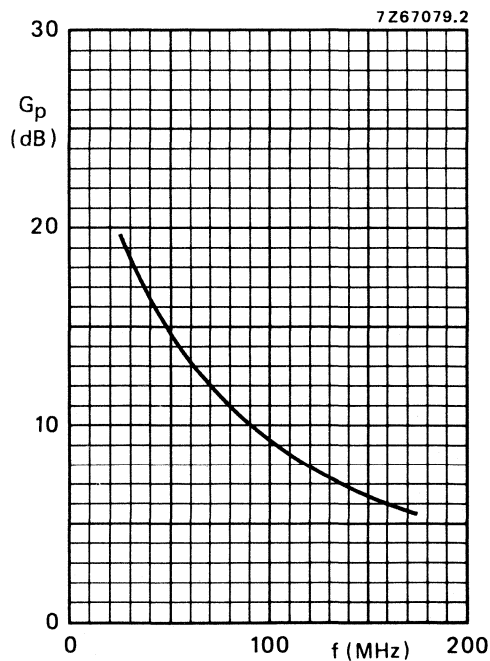


Fig. 12.

Conditions for Figs 10, 11 and 12:

Typical values;  $V_{CE} = 12,5 \text{ V}$ ;  $P_L = 45 \text{ W}$ ;

$T_h = 25 \text{ }^\circ\text{C}$ .

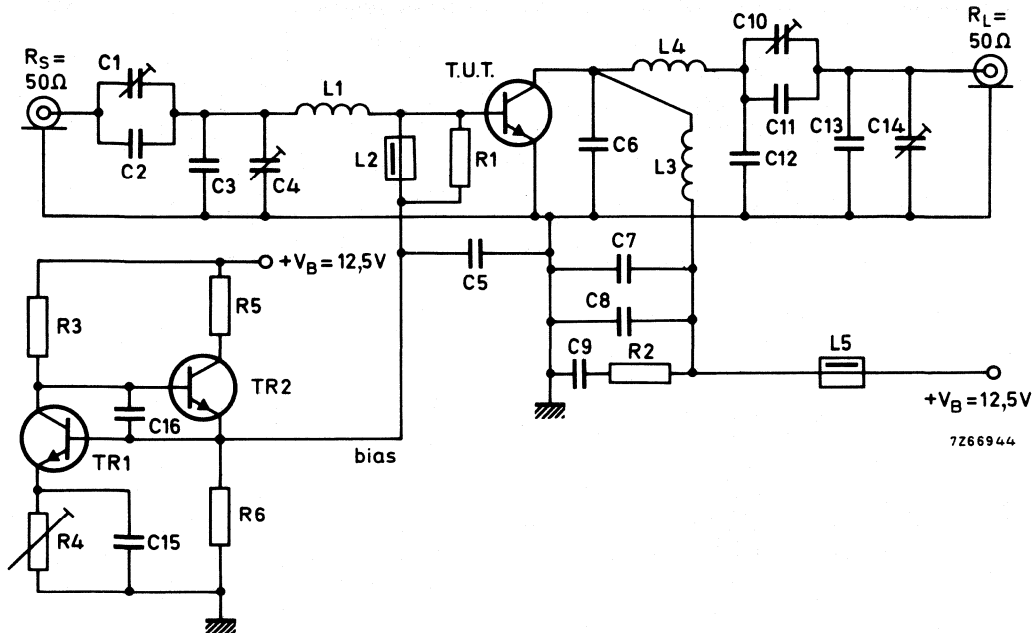
**APPLICATION INFORMATION** (continued)

R.F. performance in s.s.b. class-AB operation

 $V_{CE} = 12,5 \text{ V}$ ;  $T_h$  up to  $25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$\eta_{dt}$ %	$d_3$ dB *	$d_5$ dB *	$I_{C(ZS)}$ mA
3 to 30 (P.E.P.)	typ. 19,5	typ. 35	typ. -33	typ. -36	25

Test circuit; s.s.b. class-AB.



List of components on

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

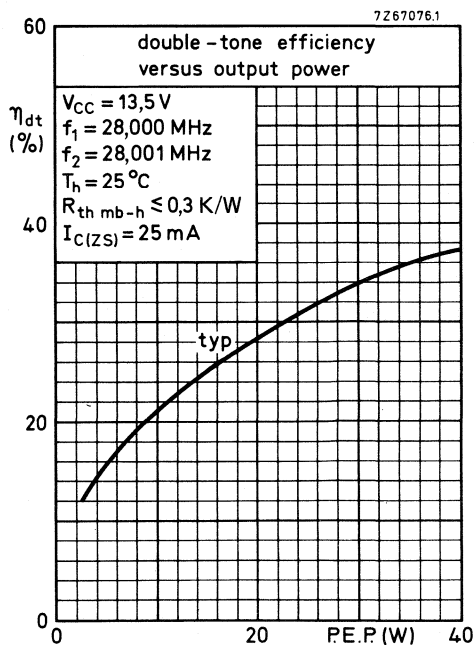
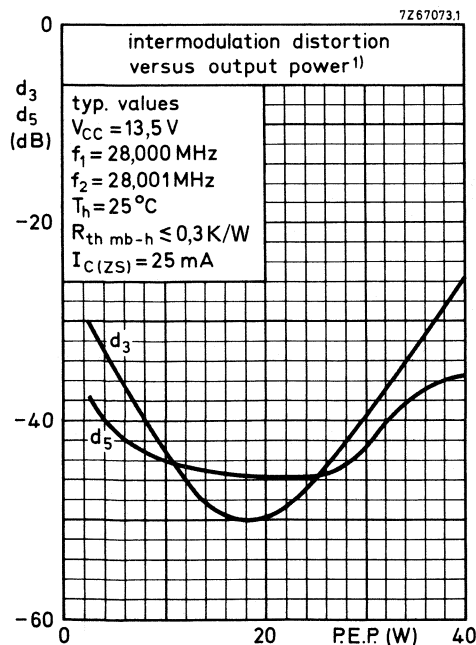
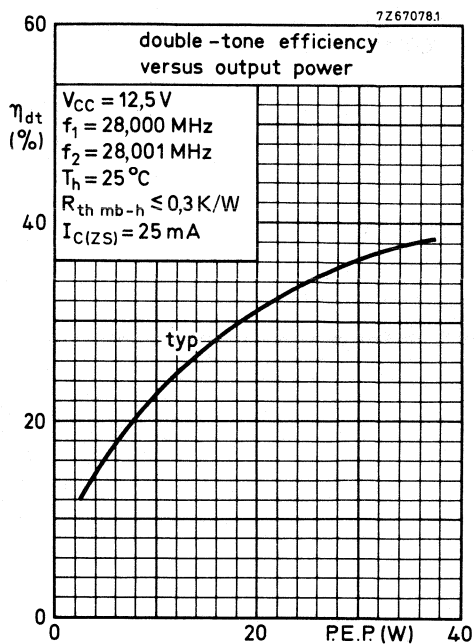
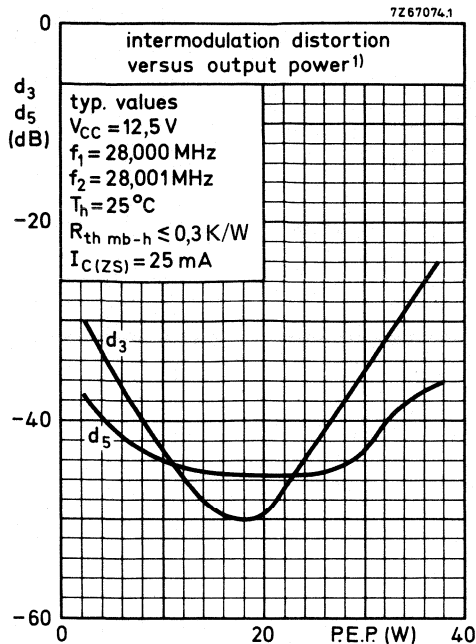
**APPLICATION INFORMATION** (continued)

List of components:

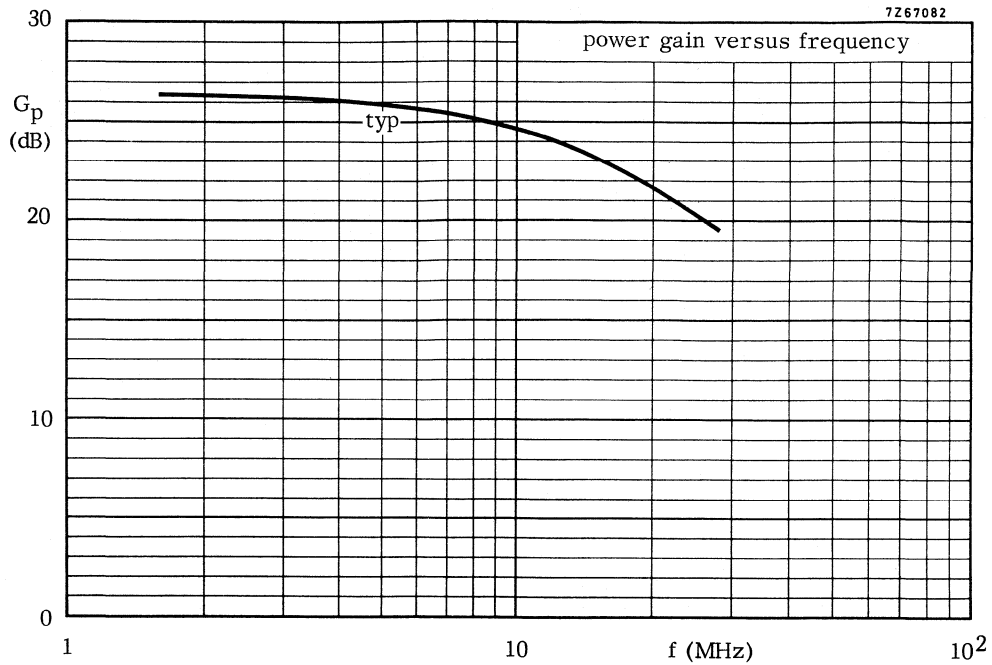
Tr1 = Tr2 = BD137

- C1 = 100 pF air dielectric capacitor (single insulated rotor)  
 C2 = 27 pF ceramic capacitor  
 C3 = 180 pF ceramic capacitor  
 C4 = 100 pF air dielectric capacitor (single non-insulated rotor)  
 C5 = C7 = 3,9 nF polyester capacitor ( $\pm 10\%$ )  
 C6 = 2 x 270 pF polystyrene capacitors in parallel  
 C8 = C15 = C16 = 100 nF polyester capacitor ( $\pm 10\%$ )  
 C9 = 2, 2  $\mu$ F moulded metallized polyester capacitor  
 C10 = 2 x 385 pF film dielectric trimmers in parallel  
 C11 = 68 pF ceramic capacitor  
 C12 = 2 x 82 pF ceramic capacitors in parallel  
 C13 = 47 pF ceramic capacitor  
 C14 = 385 pF film dielectric trimmer
- L1 = 88 nH; 3 turns Cu wire (1,0 mm); internal diameter 9 mm; coil length 6,1 mm;  
 leads 2 x 5 mm  
 L2 = L5 = ferroxcube bead, grade 3B (code number 4312 020 36640)  
 L3 = 68 nH; 3 turns enamelled Cu wire (1,6 mm); internal diameter 8 mm;  
 coil length 8,3 mm; leads 2 x 5 mm  
 L4 = 96 nH; 3 turns enamelled Cu wire (1,6 mm); internal diameter 10 mm;  
 coil length 7,6 mm; leads 2 x 5 mm
- R1 = 27  $\Omega$  carbon resistor ( $\pm 5\%$ )  
 R2 = 4,7  $\Omega$  carbon resistor ( $\pm 5\%$ )  
 R3 = 1,5 k $\Omega$  carbon resistor ( $\pm 5\%$ )  
 R4 = 10  $\Omega$  wire-wound potentiometer (3 W)  
 R5 = 47  $\Omega$  wire-wound resistor (5,5 W)  
 R6 = 150  $\Omega$  carbon resistor ( $\pm 5\%$ )





1) Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.



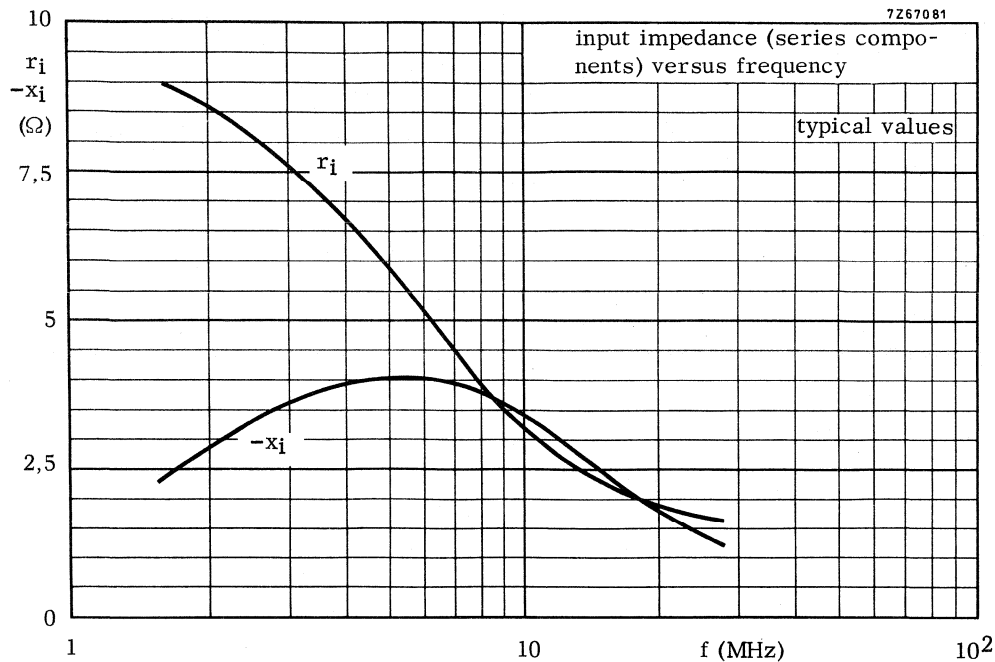
### S.S.B. class AB operation

Conditions:

$P_L = 30 \text{ W (PEP)}$   
 $V_{CC} = 12,5 \text{ V}$   
 $I_C(ZS) = 25 \text{ mA}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$   
 $Z_L = 1,9 \Omega$

$P_L = 35 \text{ W (PEP)}$   
 $V_{CC} = 13,5 \text{ V}$   
 $I_C(ZS) = 25 \text{ mA}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$   
 $Z_L = 1,9 \Omega$

The curve (both conditions) holds for an unneutralized amplifier.



### S.S.B. class AB operation

Conditions:

$P_L = 30 \text{ W (PEP)}$   
 $V_{CC} = 12,5 \text{ V}$   
 $I_C(Z_S) = 25 \text{ mA}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$   
 $Z_L = 1,9 \Omega$

$P_L = 35 \text{ W (PEP)}$   
 $V_{CC} = 13,5 \text{ V}$   
 $I_C(Z_S) = 25 \text{ mA}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$   
 $Z_L = 1,9 \Omega$

The curve (both conditions) holds for an unneutralized amplifier.



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a nominal supply voltage of 12,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V. Matched  $h_{FE}$  groups are available on request.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

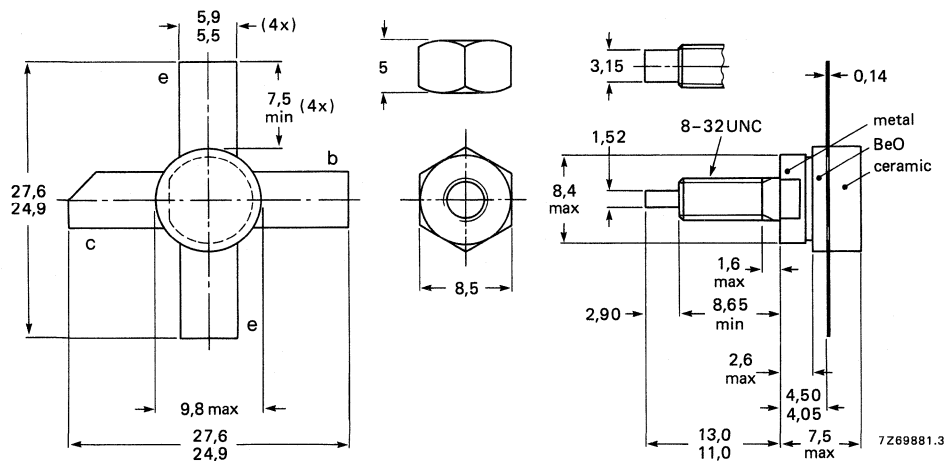
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CC}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{Z}_i$ $\Omega$	$\bar{Z}_L$ $\Omega$	$d_3$ dB
c.w. (class-B)	12,5	175	45	> 5,0	> 75	$1,2 + j1,4$	$2,6 - j1,2$	—
s.s.b. (class-AB)	12,5	1,6–28	3–30 (P.E.P.)	typ. 19,5	typ. 35	—	—	typ. –33

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or  
countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18 V
Emitter-base voltage (open-collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	9 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	22 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	100 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

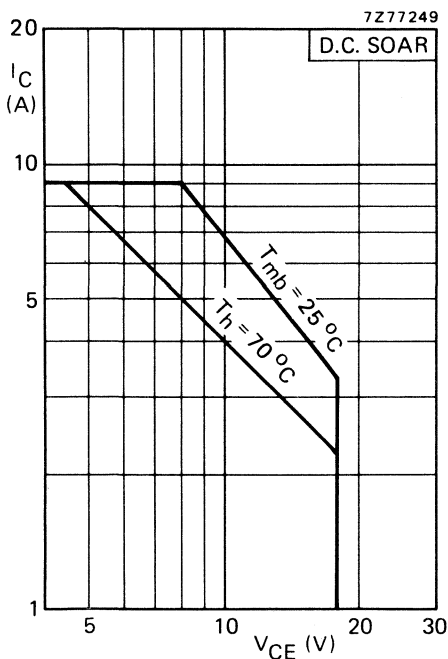


Fig. 2 D.C. SOAR.

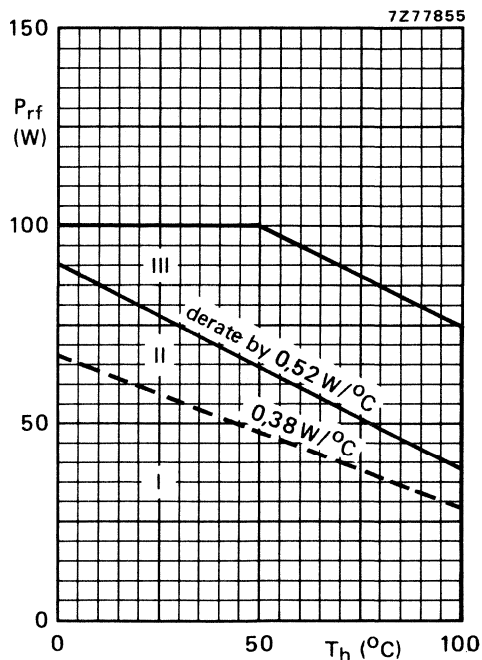


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 40 W;  $T_{mb} = 88$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	2,8 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	2,05 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,45 K/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$ **Breakdown voltage**

Collector-emitter voltage

 $V_{BE} = 0; I_C = 50\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter voltage

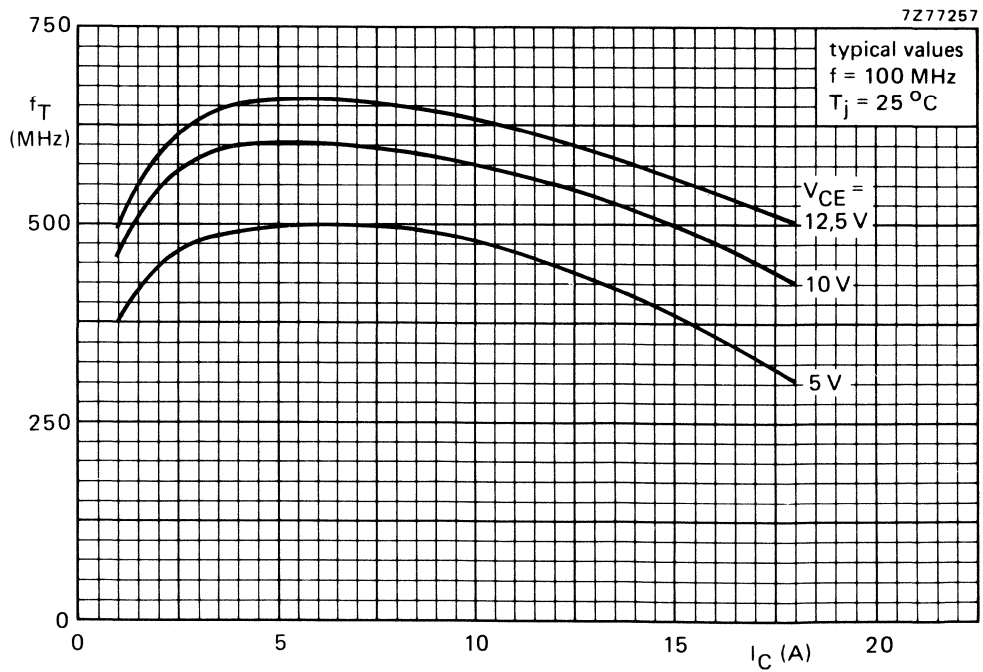
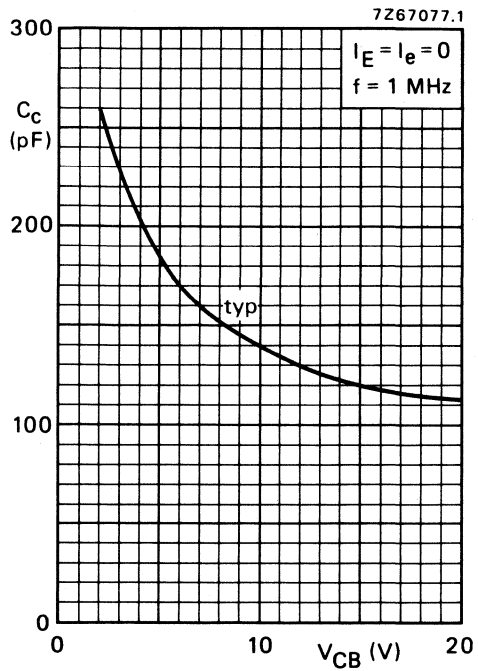
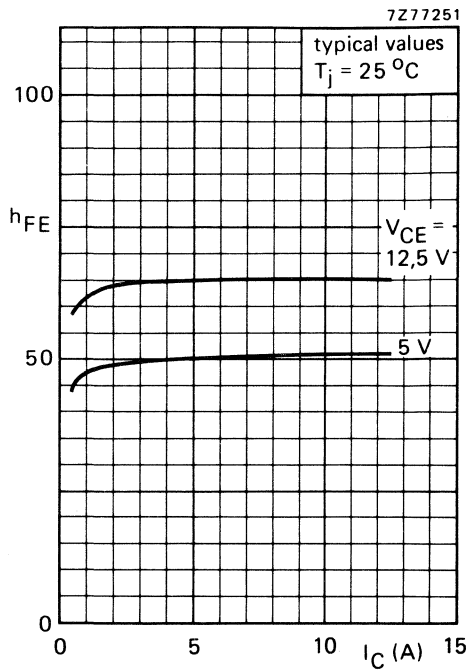
open base;  $I_C = 100\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base voltage

open collector;  $I_E = 25\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ **Collector cut-off current** $V_{BE} = 0; V_{CE} = 15\text{ V}$  $I_{CES} < 25\text{ mA}$ **Transient energy** $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $-V_{BE} = 1,5\text{ V}; R_{BE} = 33\text{ }\Omega$  $E > 8\text{ ms}$  $E > 8\text{ ms}$ **D.C. current gain \*** $I_C = 4\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ 50  
10 to 80**D.C. current gain ratio of matched devices \*** $I_C = 4\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE1}/h_{FE2} < 1,2$ **Collector-emitter saturation voltage \*** $I_C = 12,5\text{ A}; I_B = 2,5\text{ A}$  $V_{CEsat}$  typ 1,5 V**Transition frequency at  $f = 100\text{ MHz}$  \*** $I_C = 4\text{ A}; V_{CE} = 12,5\text{ V}$  $I_C = 12,5\text{ A}; V_{CE} = 12,5\text{ V}$  $f_T$  typ 650 MHz $f_T$  typ 600 MHz**Collector capacitance at  $f = 1\text{ MHz}$**  $I_E = I_e = 0; V_{CB} = 15\text{ V}$  $C_c$  typ 120 pF  
< 160 pF**Feedback capacitance at  $f = 1\text{ MHz}$**  $I_C = 200\text{ mA}; V_{CE} = 15\text{ V}$  $C_{re}$  typ 80 pF**Collector-stud capacitance** $C_{cs}$  typ 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .





## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	V <sub>CC</sub> (V)	P <sub>L</sub> (W)	P <sub>S</sub> (W)	G <sub>p</sub> (dB)	I <sub>C</sub> (A)	η (%)	$\bar{z}_i$ (Ω)	$\bar{z}_L$ (Ω)
175	12,5	45	< 14,2	> 5,0	< 4,8	> 75	1,2 + j1,4	2,6 - j1,2
175	13,5	45	—	typ. 6,0	—	typ. 75	—	—

Test circuit for 175 MHz

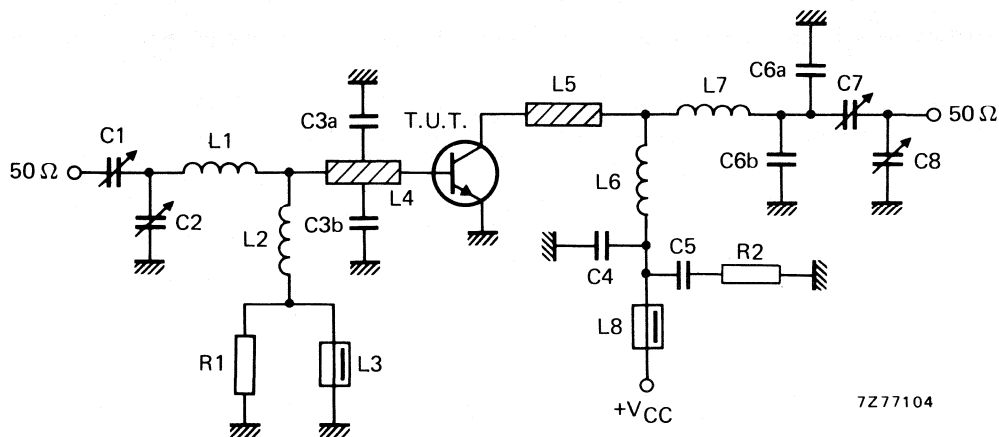


Fig. 7 Class-B test circuit at f = 175 MHz.

List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C8 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor

C5 = 100 nF polyester capacitor

C6a = C6b = 8,2 pF ceramic capacitor (500 V)

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 1 turn Cu wire (1,6 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L6 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 5,0 mm; length 6,0 mm; leads 2 x 5 mm

L7 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,5 mm; length 6,0 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10 Ω (±10%) carbon resistor

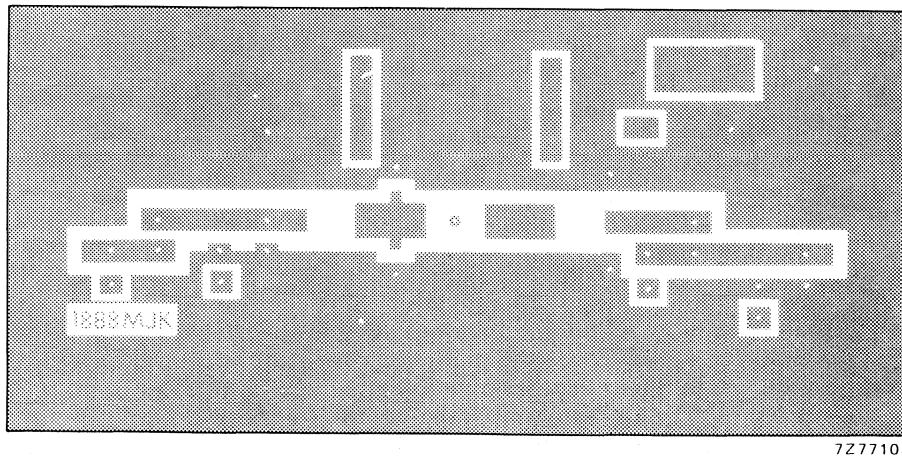
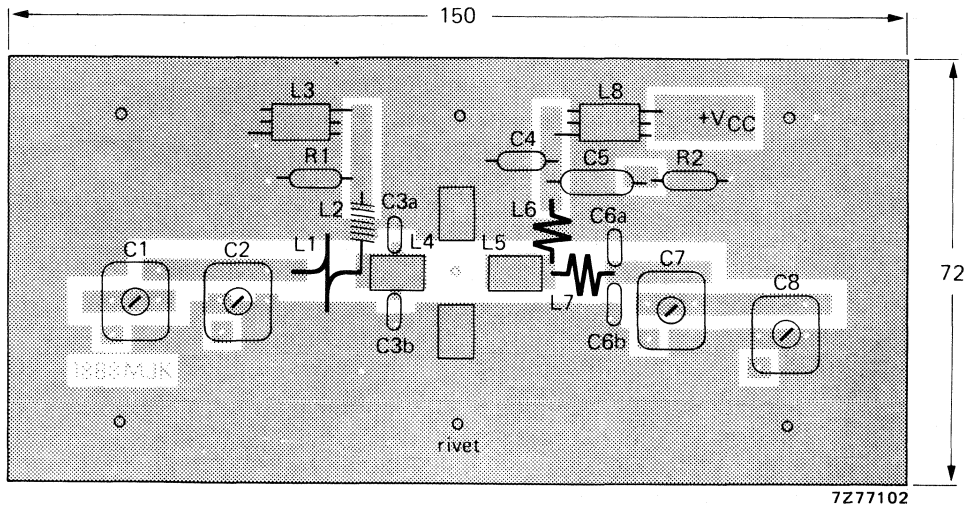
R2 = 4,7 Ω (±5%) carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit on

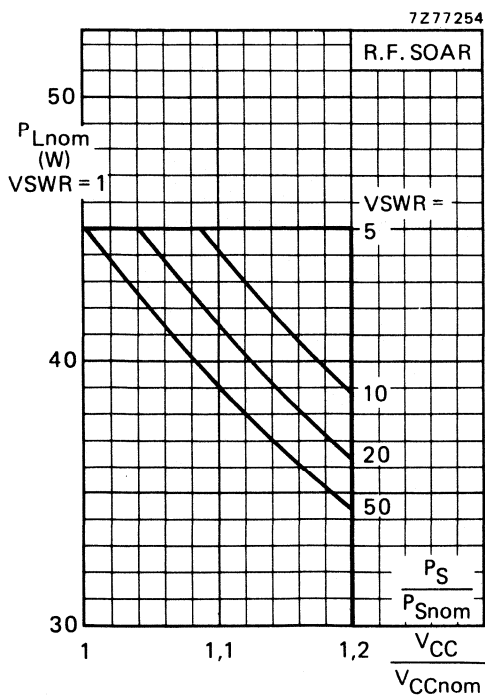
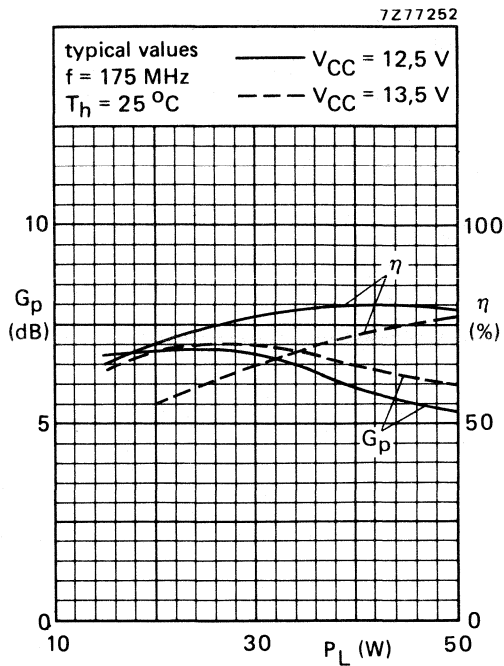
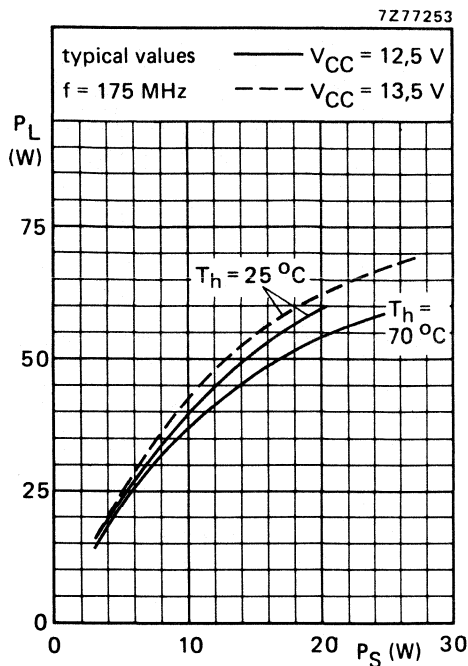
7277104

APPLICATION INFORMATION (continued)

Component layout and printed-circuit board for 175 MHz test circuit.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.



Conditions for R.F. SOAR

$f = 175 \text{ MHz}$   
 $T_h = 70 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} = 0,45 \text{ K/W}$   
 $V_{CCnom} = 12,5 \text{ V or } 13,5 \text{ V}$   
 $P_S = P_{Snom}$  at  $V_{CCnom}$  and  $VSWR = 1$   
 see

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ), as a function of the expected supply over-voltage ratio with  $VSWR$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

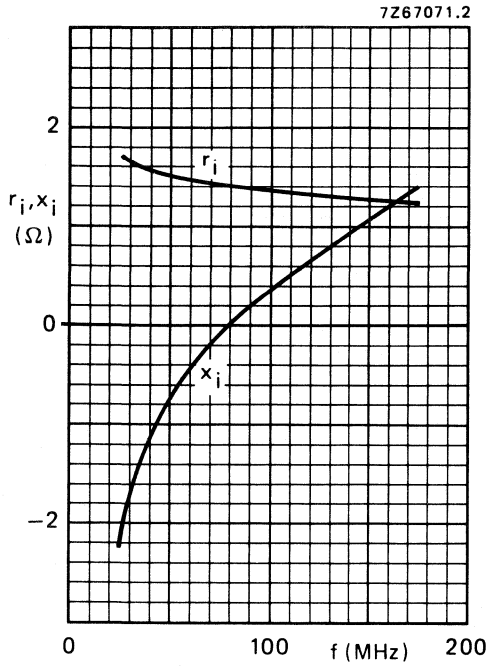


Fig. 12 Input impedance (series components).

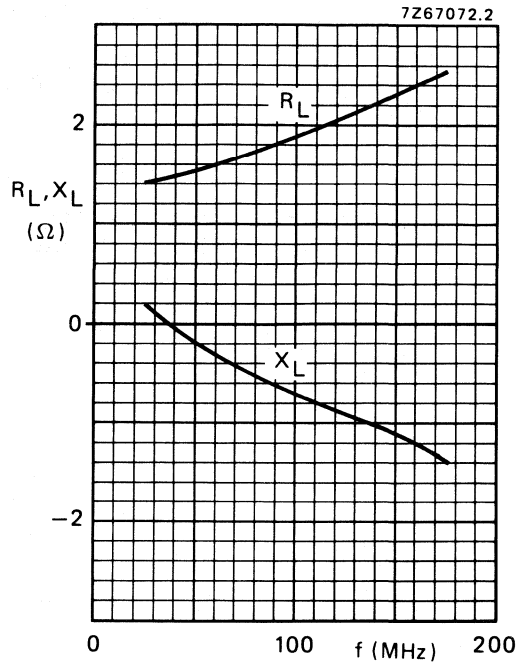


Fig. 13 Load impedance (series components).

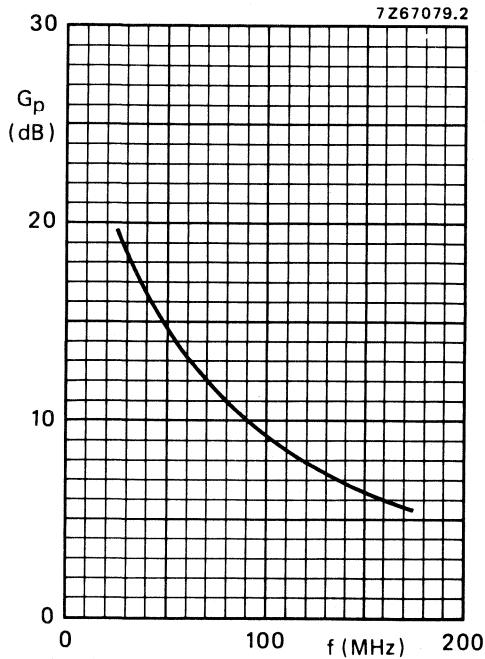


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 12,5$  V;  $P_L = 45$  W;  
class-B operation;  $T_h = 25$  °C.

## APPLICATION INFORMATION (continued)

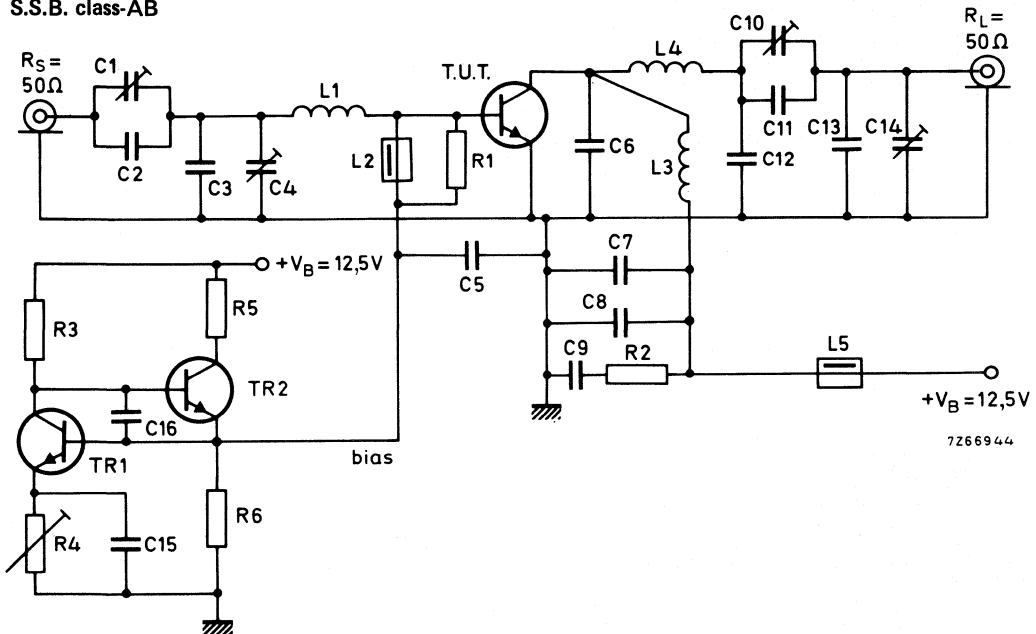
R.F. performance in s.s.b. class-AB operation

$V_{CE} = 12,5 \text{ V}$ ;  $T_h$  up to  $25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} \leq 0,45 \text{ K/W}$   
 $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$\eta_{dt}$ %	$d_3$ dB *	$d_5$ dB *	$I_{C(ZS)}$ mA
3 to 30 (P.E.P.)	typ 19,5	typ 35	typ -33	typ -36	25

Test circuit

## S.S.B. class-AB



List of components:

TR1 = TR2 = BD137

C1 = 100 pF air dielectric trimmer (single insulated rotor type)

C2 = 27 pF ceramic capacitor

C3 = 180 pF ceramic capacitor

C4 = 100 pF air dielectric trimmer (single non-insulated rotor type)

C5 = C7 = 3,9 nF polyester capacitor

C6 = 2 x 270 pF polystyrene capacitors in parallel

C8 = C15 = C16 = 100 nF polyester capacitor

C9 = 2,2  $\mu\text{F}$  moulded metallized polyester capacitor

C10 = 2 x 385 pF film dielectric trimmer

C11 = 68 pF ceramic capacitor

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

**APPLICATION INFORMATION** (continued)

List of components (continued)

C12 = 2 x 82 pF ceramic capacitors in parallel

C13 = 47 pF ceramic capacitor

C14 = 385 pF film dielectric trimmer

L1 = 88 nH; 3 turns Cu wire (1,0 mm); int. dia. 9 mm; length 6,1 mm; leads 2 x 5 mm

L2 = L5 = Ferroxcube choke coil (cat. no. 4312 020 36640)

L3 = 68 nH; 3 turns enamelled Cu wire (1,6 mm); int. dia. 8 mm; length 8,3 mm; leads 2 x 5 mm

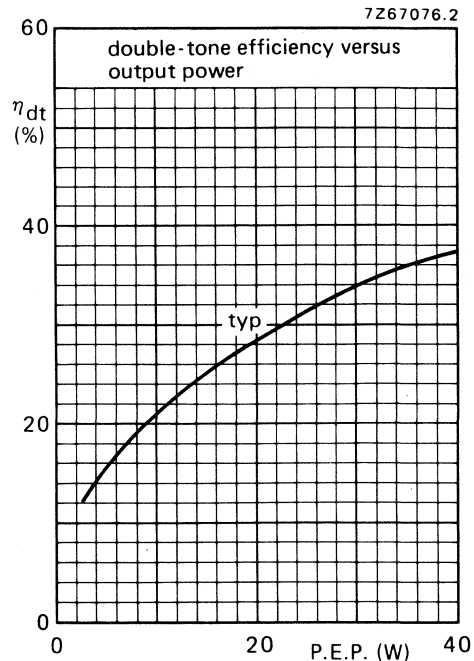
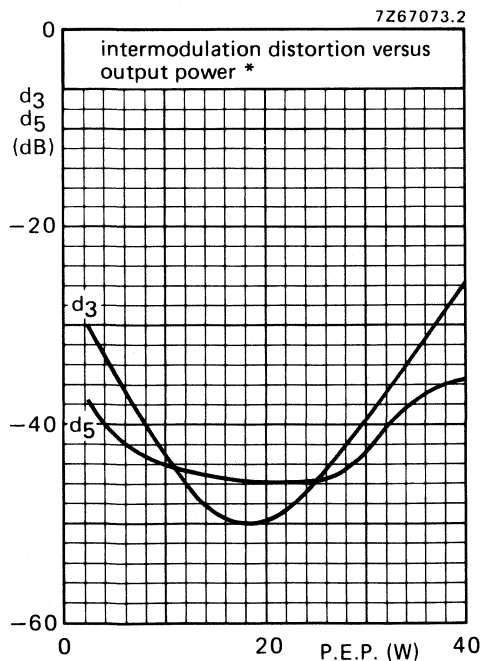
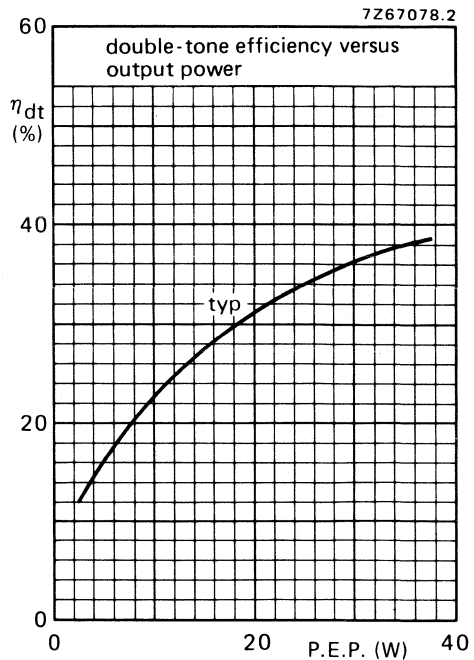
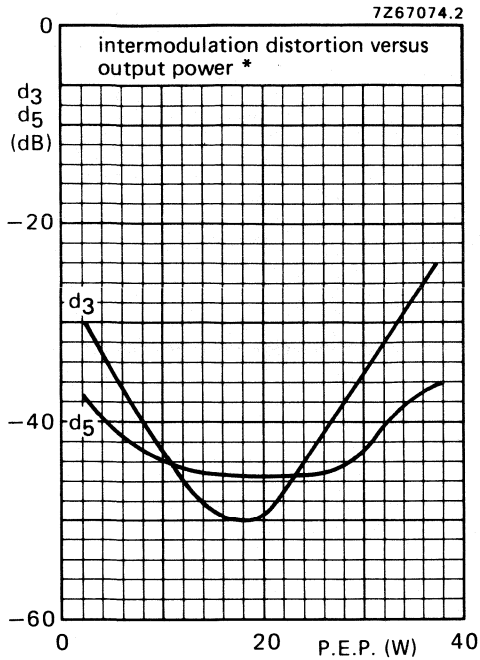
L4 = 96 nH; 3 turns enamelled Cu wire (1,6 mm); int. dia. 10 mm; length 7,6 mm; leads 2 x 5 mm

R1 = 27  $\Omega$  ( $\pm 5\%$ ) carbon resistorR2 = 4,7  $\Omega$  ( $\pm 5\%$ ) carbon resistorR3 = 1,5 k $\Omega$  ( $\pm 5\%$ ) carbon resistorR4 = 10  $\Omega$  wirewound potentiometer (3 W)R5 = 47  $\Omega$  wirewound resistor (5,5 W)R6 = 150  $\Omega$  ( $\pm 5\%$ ) carbon resistor**Measuring conditions for the upper graphs on page 11** $V_{CC} = 12,5 \text{ V}$  $f_1 = 28,000 \text{ MHz}$  $f_2 = 28,001 \text{ MHz}$  $T_h = 25 \text{ }^\circ\text{C}$  $R_{th \text{ mb-h}} \leq 0,45 \text{ }^\circ\text{K/W}$  $I_{C(ZS)} = 25 \text{ mA}$ 

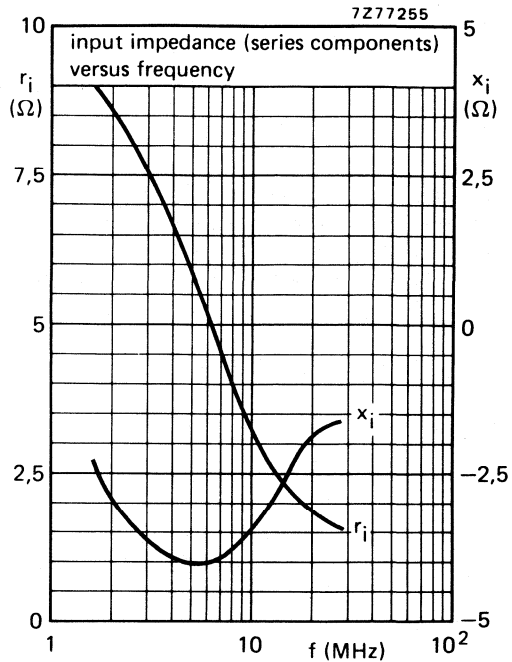
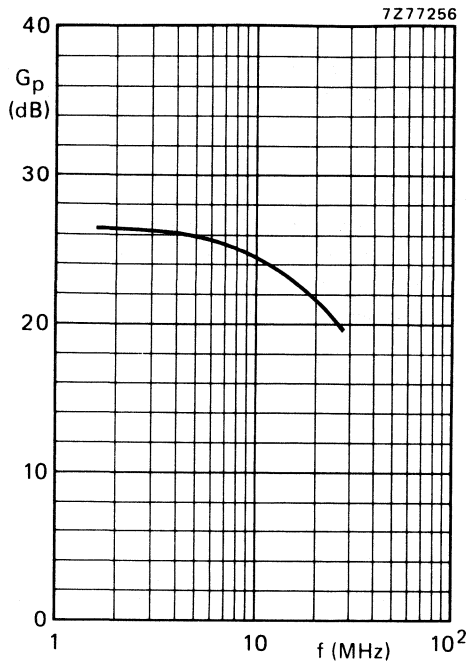
typical values

**Measuring conditions for the lower graphs on page 11** $V_{CC} = 13,5 \text{ V}$  $f_1 = 28,000 \text{ MHz}$  $f_2 = 28,001 \text{ MHz}$  $T_h = 25 \text{ }^\circ\text{C}$  $R_{th \text{ mb-h}} \leq 0,45 \text{ }^\circ\text{K/W}$  $I_{C(ZS)} = 25 \text{ mA}$ 

typical values



\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.



**S.S.B. class-AB operation**

Conditions for the graphs above:

$V_{CC} = 12,5 \text{ V}$   
 $P_L = 30 \text{ W (P.E.P.)}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} \leq 0,45 \text{ K/W}$   
 $I_{C(ZS)} = 25 \text{ mA}$   
 $Z_L = 1,9 \text{ } \Omega$

$V_{CC} = 13,5 \text{ V}$   
 $P_L = 35 \text{ W (P.E.P.)}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} \leq 0,45 \text{ K/W}$   
 $I_{C(ZS)} = 25 \text{ mA}$   
 $Z_L = 1,9 \text{ } \Omega$

The typical curves (both conditions) hold for an unneutralized amplifier.



## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-AB or class-B operated high power transmitters in the h.f. and v.h.f. bands. The transistor presents excellent performance as a linear amplifier in the h.f. band. It is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Transistors are delivered in matched  $h_{FE}$  groups.

The transistor has a  $\frac{1}{2}$ " flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25^\circ\text{C}$

mode of operation	$V_{CE}$ V	$I_C(ZS)$ A	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$d_3$ dB
s.s.b. (class-AB)	28	0,05	1,6–28	8–80 (P.E.P.)	> 13	> 35*	< -30
c.w. (class-B)	28	—	108	80	typ. 7,9	typ. 70	—

\* At 80 W P.E.P.

### MECHANICAL DATA

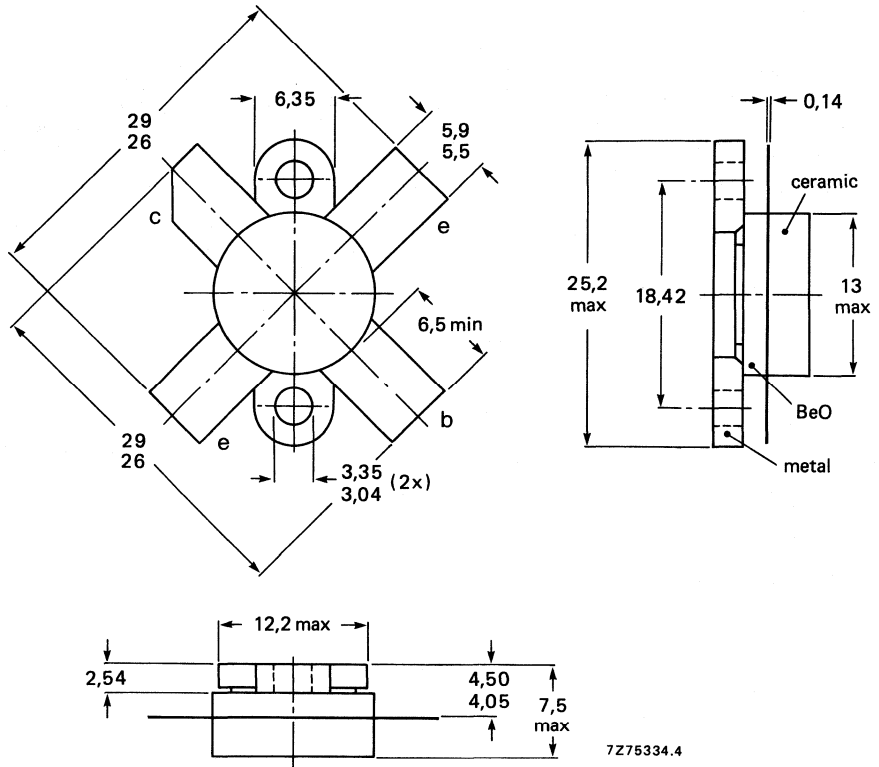
SOT-121 (see Fig.1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-121.

Dimensions in mm



Torque on screw: min. 0,6 Nm (6 kg cm)

max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	70 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	35 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	8 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	20 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	140 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

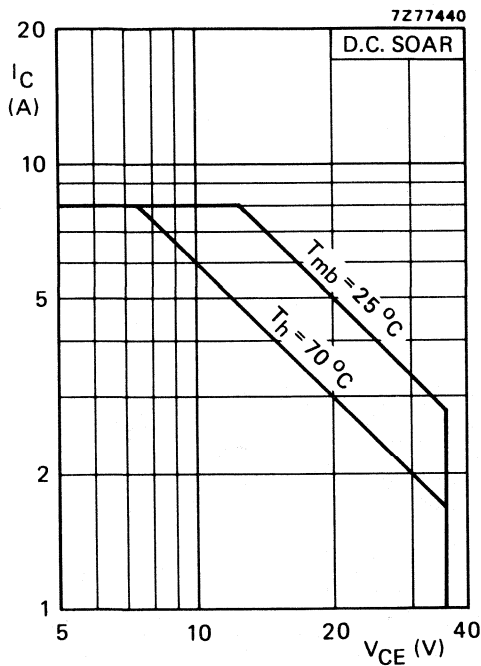


Fig. 2 D.C. SOAR.

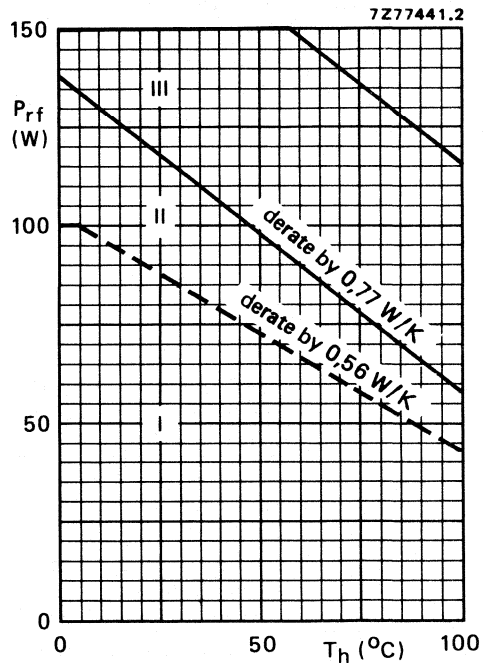


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 60 W;  $T_{mb} = 82$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	1,92 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	1,33 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,2 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage $V_{BE} = 0; I_C = 50\text{ mA}$	$V_{(BR)CES}$	>	70 V
Collector-emitter breakdown voltage open base; $I_C = 50\text{ mA}$	$V_{(BR)CEO}$	>	35 V
Emitter-base breakdown voltage open collector; $I_E = 10\text{ mA}$	$V_{(BR)EBO}$	>	4 V
Collector cut-off current $V_{BE} = 0; V_{CE} = 35\text{ V}$	$I_{CES}$	<	10 mA
D.C. current gain* $I_C = 4\text{ A}; V_{CE} = 5\text{ V}$	$h_{FE}$		15 to 80
D.C. current gain ratio of matched devices* $I_C = 4\text{ A}; V_{CE} = 5\text{ V}$	$h_{FE1}/h_{FE2}$	<	1,2
Collector-emitter saturation voltage* $I_C = 12,5\text{ A}; I_B = 2,5\text{ A}$	$V_{CEsat}$	typ.	2,5 V
Transition frequency at $f = 100\text{ MHz}$ ** $-I_E = 4\text{ A}; V_{CB} = 28\text{ V}$ $-I_E = 12,5\text{ A}; V_{CB} = 28\text{ V}$	$f_T$	typ.	315 MHz
	$f_T$	typ.	305 MHz
Collector capacitance at $f = 1\text{ MHz}$ $I_E = I_e = 0; V_{CB} = 28\text{ V}$	$C_c$	typ.	125 pF
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 50\text{ mA}; V_{CE} = 28\text{ V}$	$C_{re}$	typ.	85 pF
Collector-flange capacitance	$C_{cf}$	typ.	3 pF

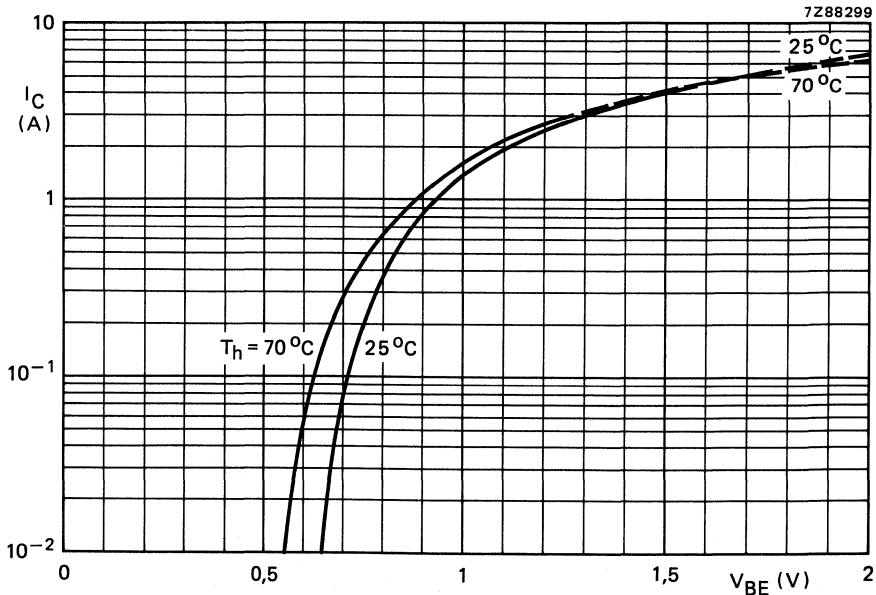


Fig. 4 Typical values;  $V_{CE} = 20\text{ V}$ .

\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}$ ;  $\delta \leq 0,02$ .

\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}$ ;  $\delta \leq 0,01$ .

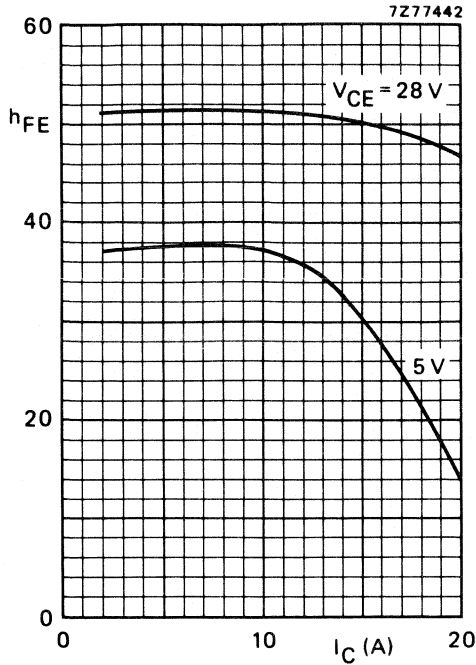


Fig. 5 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

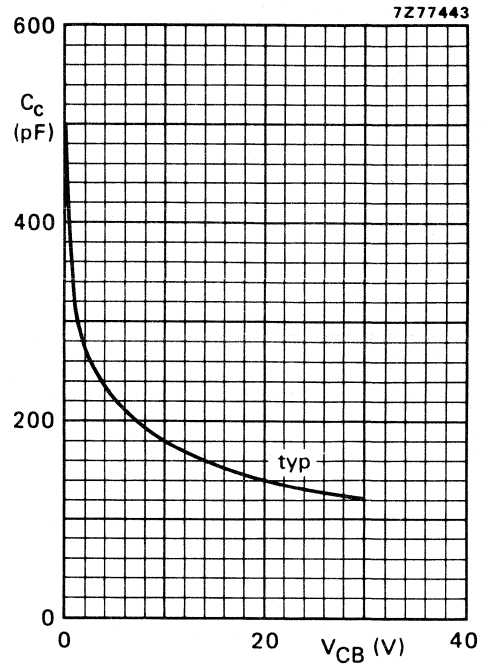


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

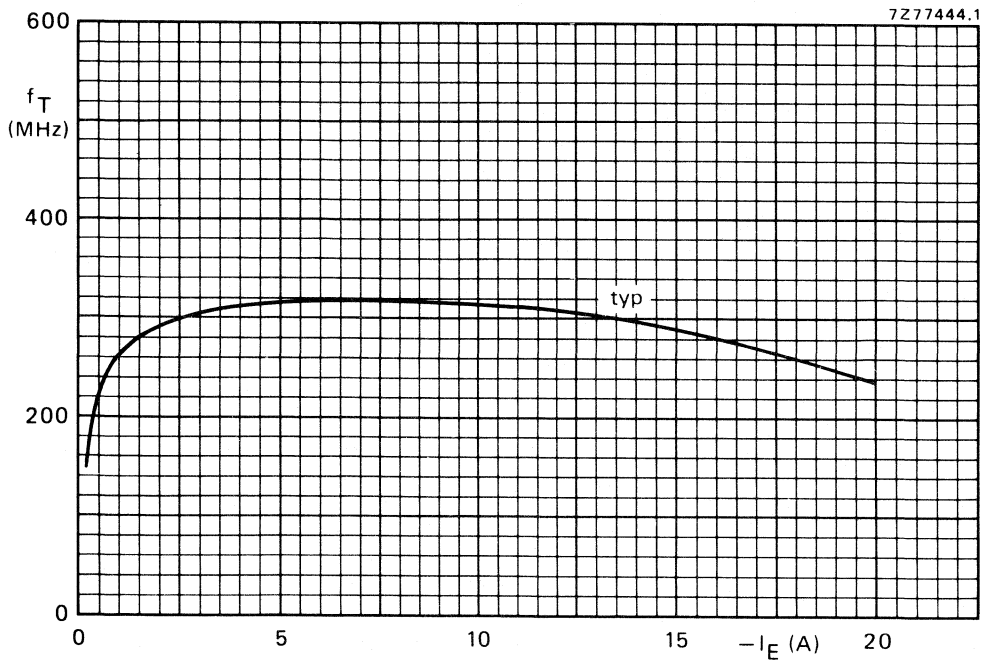


Fig. 7  $V_{CB} = 28\text{ V}$ ;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in s.s.b. class-AB operation (linear power amplifier)

 $V_{CE} = 28 \text{ V}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$\eta_{dt}$ (%) at 80 W P.E.P.	$I_C$ (A)	$d_3$ dB	$d_5$ dB	$I_C(ZS)$ A
8 to 80 (P.E.P.)	> 13	> 35	< 4,1	< -30	< -30	0,05

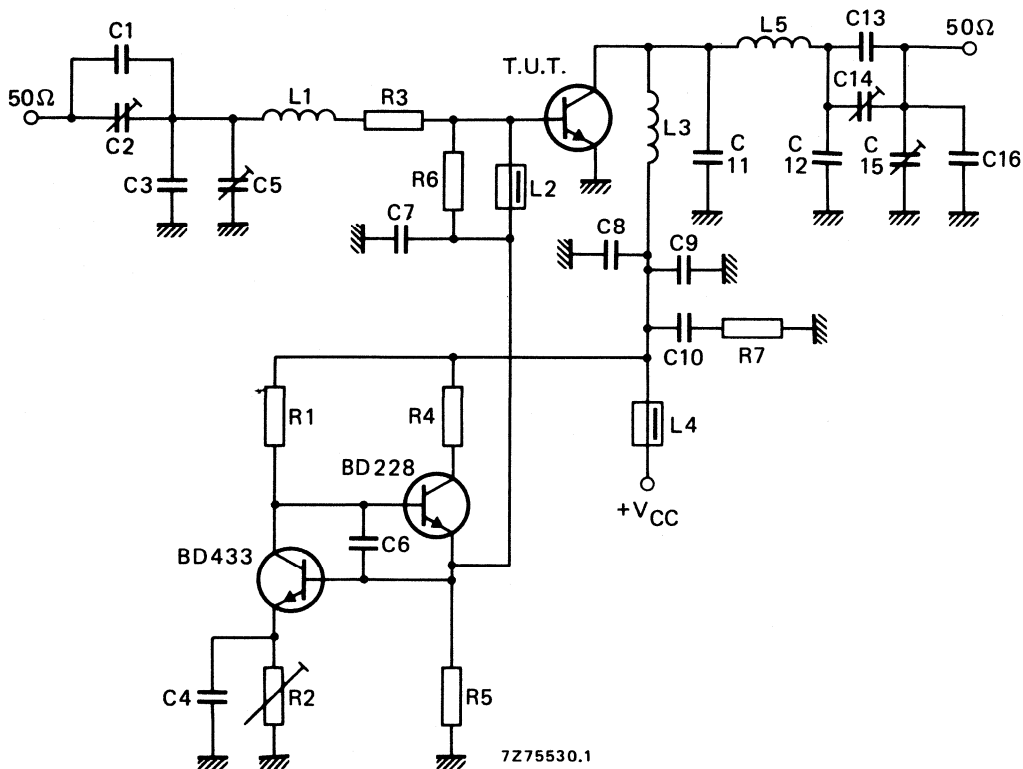


Fig. 8 Test circuit; s.s.b. class-AB.

## List of components:

C1 = 27 pF ceramic capacitor (500 V)

C2 = 100 pF air dielectric trimmer (single insulated rotor type)

C3 = 100 pF polystyrene capacitor

C4 = C6 = C9 = 100 nF polyester capacitor

C5 = 280 pF air dielectric trimmer (single non-insulated rotor type)

C7 = C8 = 3,9 nF ceramic capacitor

C10 = 2,2  $\mu$ F moulded metallized polyester capacitor

C11 = 180 pF polystyrene capacitor

C12 = 2 x 68 pF ceramic capacitors in parallel (500 V)

C13 = 120 pF polystyrene capacitor

C14 = C15 = 280 pF air dielectric trimmer (single insulated rotor type)

C16 = 56 pF ceramic capacitor (500 V)

L1 = 108 nH; 4 turns Cu wire (1,6 mm); int. dia. 8,7 mm; length 11,2 mm; leads 2 x 7 mm

L2 = L4 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 88 nH; 3 turns Cu wire (1,6 mm); int. dia. 8,0 mm; length 8,0 mm; leads 2 x 7 mm

L5 = 120 nH; 4 turns Cu wire (1,6 mm); int. dia. 9,3 mm; length 11,2 mm; leads 2 x 7 mm

R1 = 1,5 k $\Omega$  ( $\pm$  5%) carbon resistor (0,5 W)

R2 = 10  $\Omega$  wirewound potentiometer (3 W)

R3 = 0,9  $\Omega$ ; parallel connection of 2 x 1,8  $\Omega$  carbon resistors ( $\pm$  5%; 0,5 W each)

R4 = 60  $\Omega$ ; parallel connection of 2 x 120  $\Omega$  wirewound resistors (5,5 W each)

R5 = 56  $\Omega$  ( $\pm$  5%) carbon resistor (0,5 W)

R6 = 33  $\Omega$  ( $\pm$  5%) carbon resistor (0,5 W)

R7 = 4,7  $\Omega$  ( $\pm$  5%) carbon resistor (0,5 W)

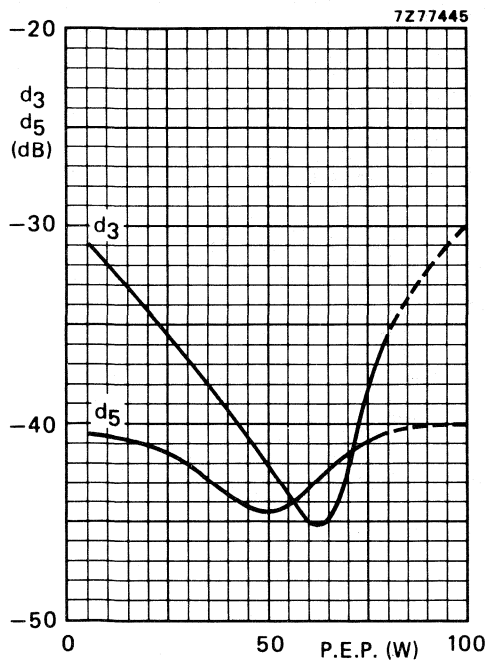


Fig. 9 Intermodulation distortion as a function of output power.\*

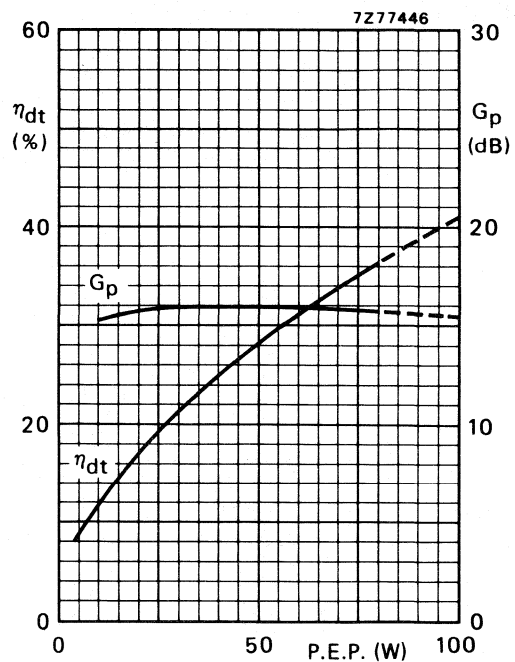


Fig. 10 Double-tone efficiency and power gain as a function of output power.

Conditions for Figs 9 and 10:

$V_{CE} = 28$  V;  $I_{C(ZS)} = 50$  mA;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  $T_h = 25$  °C; typical values.

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

APPLICATION INFORMATION (continued)

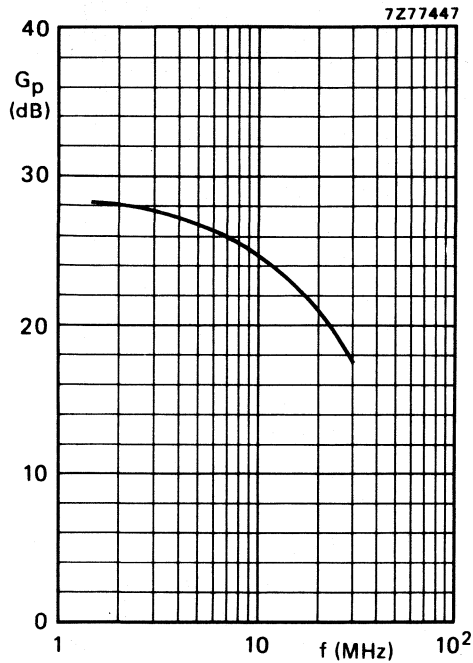


Fig. 11 Power gain as a function of frequency.

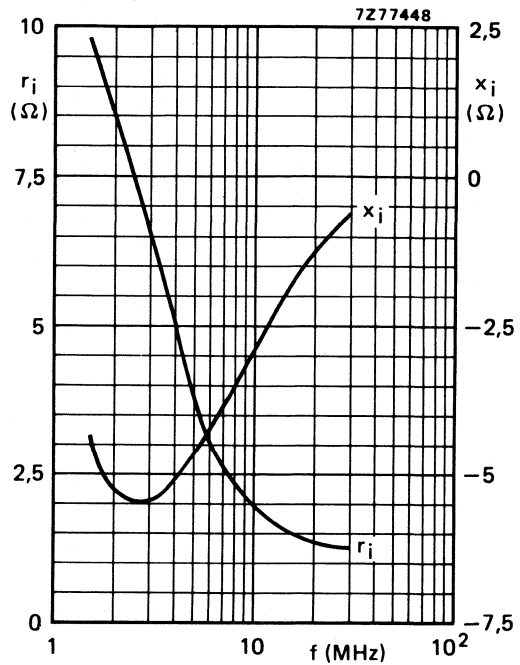


Fig. 12 Input impedance (series components) as a function of frequency.

Figs 11 and 12 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $P_L = 80 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 3,9 \text{ } \Omega$ .



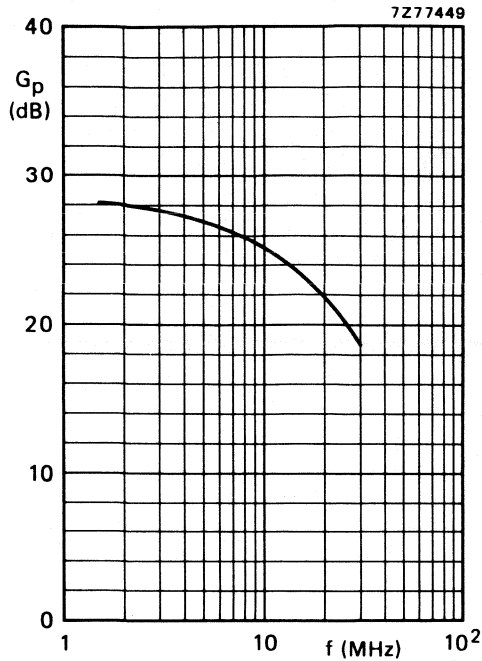


Fig. 13 Power gain as a function of frequency.

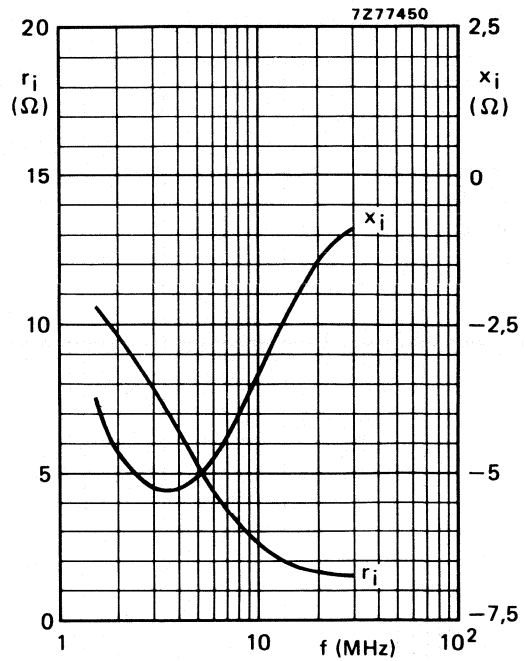


Fig. 14 Input impedance (series components) as a function of frequency.

Figs 13 and 14 are typical curves and hold for a push-pull amplifier with cross-neutralization in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $P_L = 80 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 3,9 \text{ } \Omega$ ; neutralizing capacitor:  $68 \text{ pF}$ .

APPLICATION INFORMATION (continued)

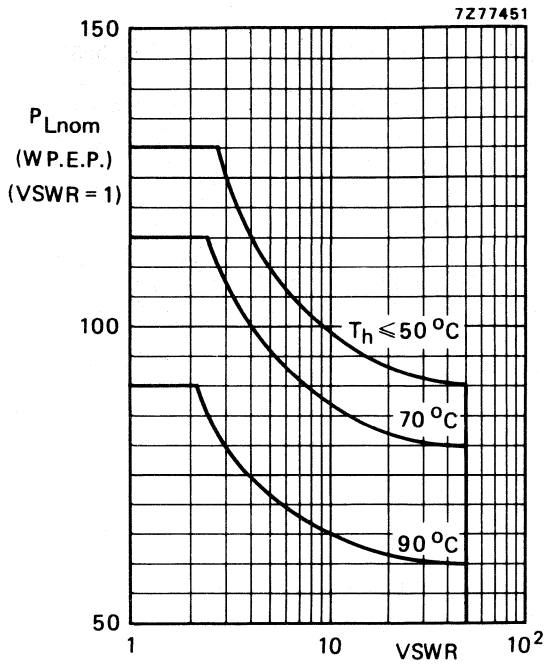


Fig. 15 R.F. SOAR; s.s.b. class-AB operation;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  $V_{CE} = 28$  V;  $R_{th\ mb-h} = 0,2$  K/W. The graph shows the permissible output power under nominal conditions (VSWR = 1) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
108	28	80	typ. 13	typ. 7,9	typ. 4,1	typ. 70	$0,85 + j1,0$	$174 - j40$

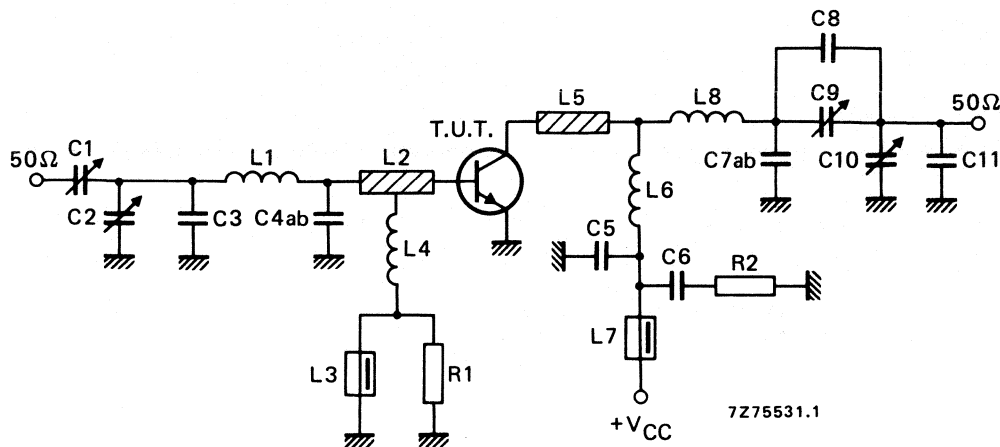


Fig. 16 Test circuit; c.w. class-B.

List of components:

C1 = C9 = C10 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C2 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3 = 22 pF ceramic capacitor (500 V)

C4ab = 2 × 82 pF ceramic capacitors in parallel (500 V)

C5 = 270 pF polystyrene capacitor

C6 = 100 nF polyester capacitor

C7a = 8,2 pF ceramic capacitor (500 V)

C7b = 10 pF ceramic capacitor (500 V)

C8 = 5,6 pF ceramic capacitor (500 V)

C11 = 10 pF ceramic capacitor (500 V)

L1 = 21 nH; 2 turns Cu wire (1,0 mm); int. dia. 4,0 mm; length 3,5 mm; leads 2 × 5 mm

L2 = L5 = 2,4 nH; strip (12 mm × 6 mm); tap for L4 at 6 mm from transistor

L3 = L7 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 × 5 mm

L6 = 49 nH; 2 turns Cu wire (1,6 mm); int. dia. 9,0 mm; length 4,7 mm; leads 2 × 5 mm

L8 = 56 nH; 2 turns Cu wire (1,6 mm); int. dia. 10,0 mm; length 4,5 mm; leads 2 × 5 mm

L2 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric.

R1 = R2 = 10  $\Omega$  ( $\pm 10\%$ ) carbon resistor

Component layout and printed-circuit board for 108 MHz test circuit are shown in Fig. 17.

## APPLICATION INFORMATION (continued)

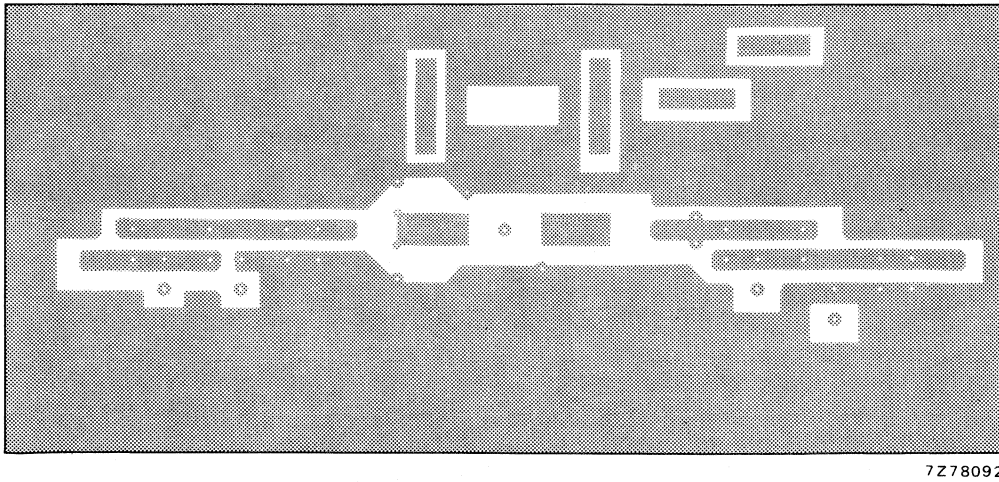
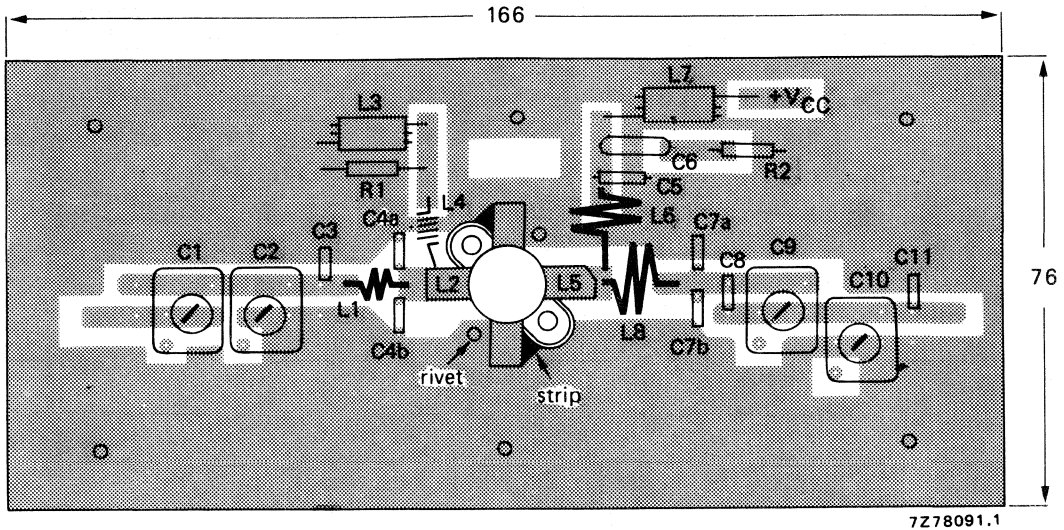


Fig. 17 Component layout and printed-circuit board for 108 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

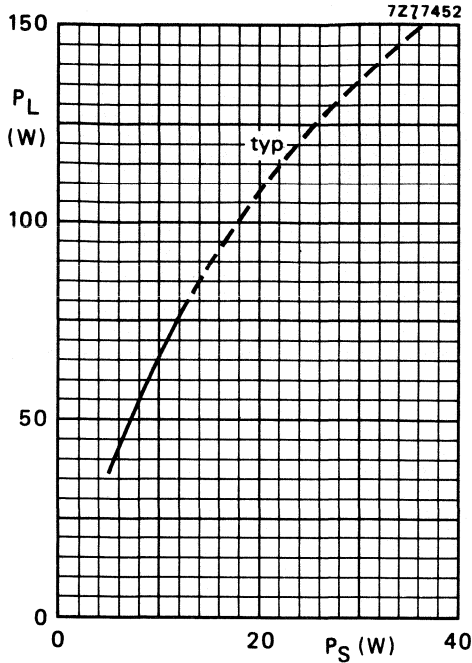


Fig. 18  $V_{CE} = 28 \text{ V}$ ;  $f = 108 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

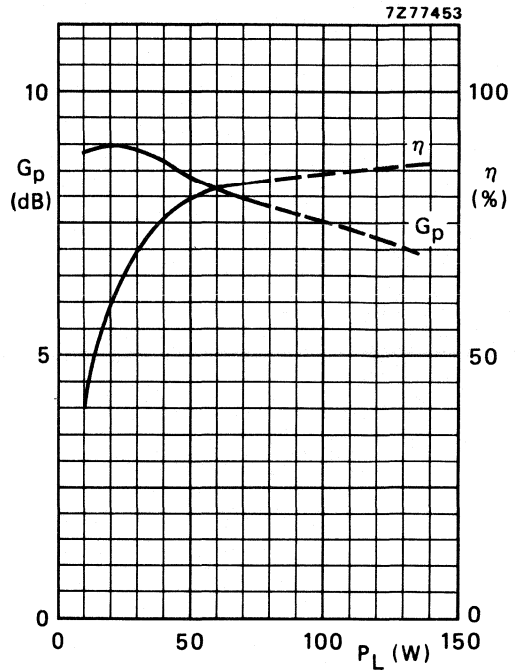


Fig. 19  $V_{CE} = 28 \text{ V}$ ;  $f = 108 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; typical values.

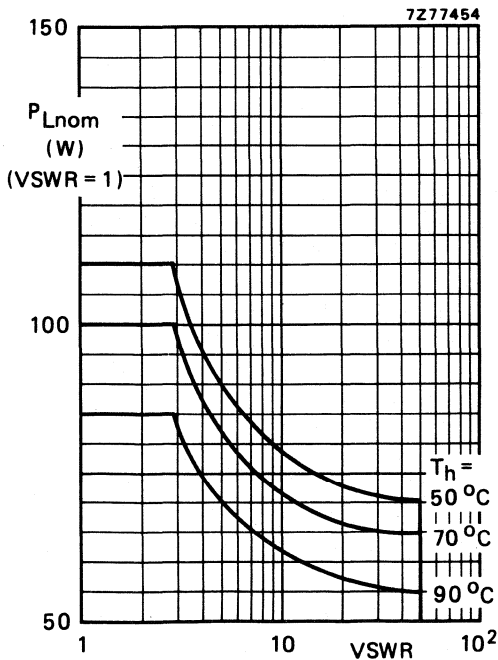


Fig. 20 R.F. SOAR; c.w. class-B operation;  $f = 108 \text{ MHz}$ ;  $V_{CE} = 28 \text{ V}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ . The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

APPLICATION INFORMATION (continued)

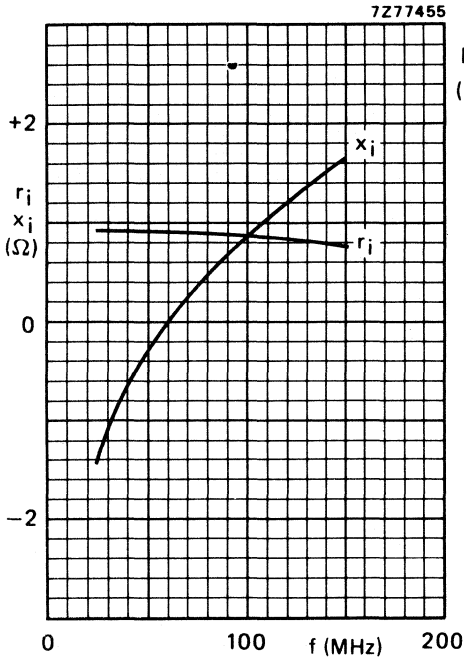


Fig. 21  $V_{CE} = 28 \text{ V}$ ;  $P_L = 80 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$   
typical values.

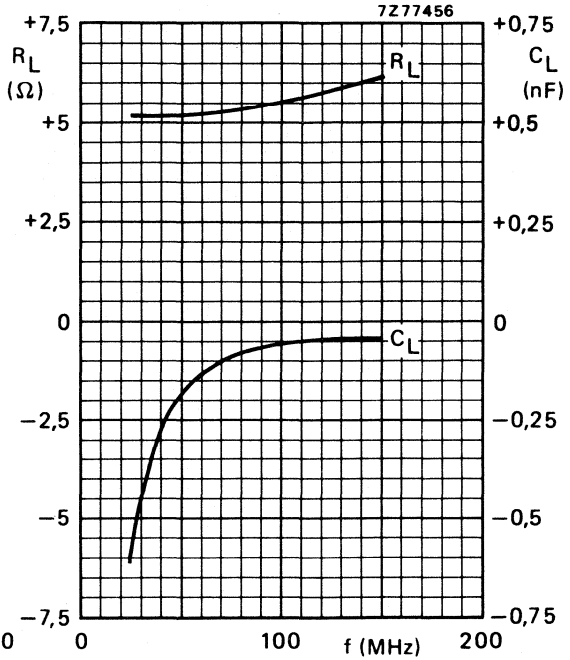


Fig. 22  $V_{CE} = 28 \text{ V}$ ;  $P_L = 80 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  
typical values.

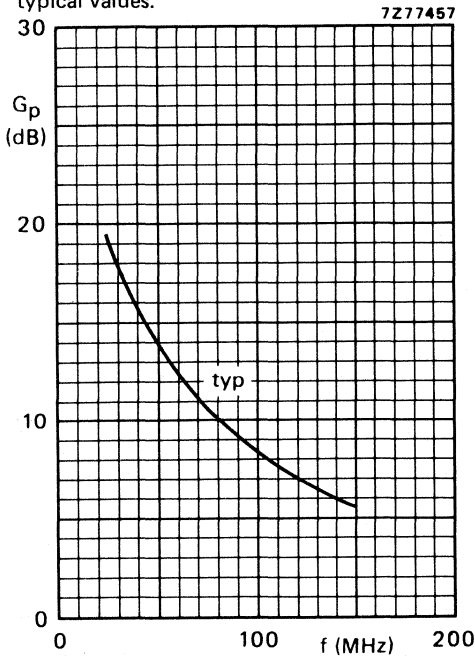


Fig. 23  $V_{CE} = 28 \text{ V}$ ;  $P_L = 80 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-AB or class-B operated high power transmitters in the h.f. and v.h.f. bands. The transistor presents excellent performance as a linear amplifier in the h.f. band. It is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Transistors are delivered in matched  $h_{FE}$  groups.

The transistor has a  $\frac{1}{2}$ " flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25^\circ\text{C}$

mode of operation	$V_{CE}$ V	$I_{C(ZS)}$ A	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$d_3$ dB
s.s.b. (class-AB)	28	0,1	1,6–28	15–130 (P.E.P.)	> 12	> 37,5*	< -30
c.w. (class-B)	28	—	87,5	130	typ. 7,5	typ. 75	—

\* At 130 W P.E.P.

### MECHANICAL DATA

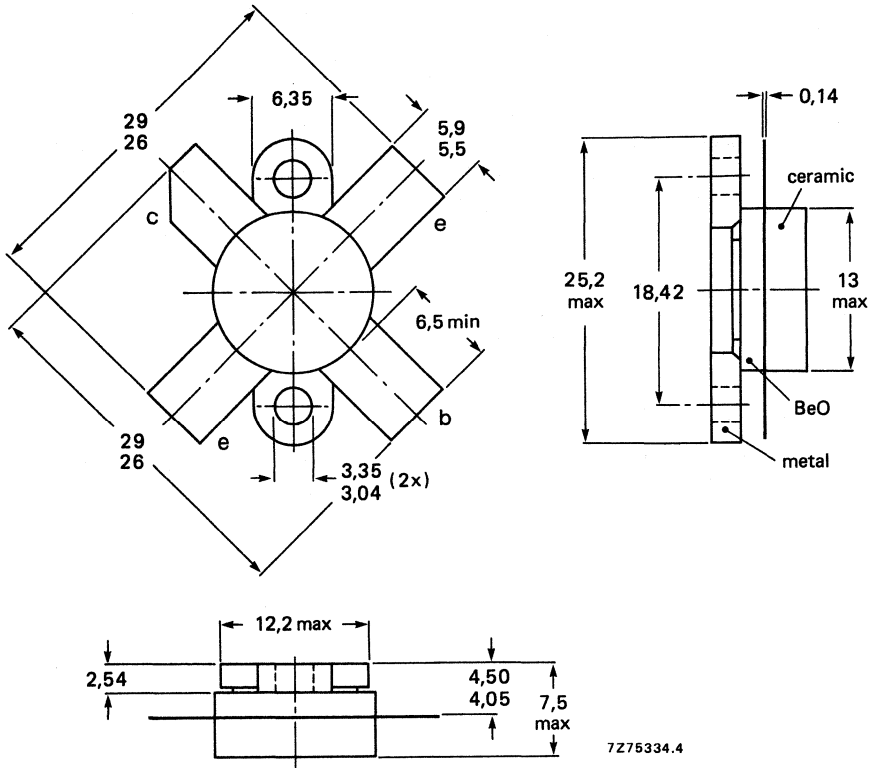
SOT-121 (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-121.

Dimensions in mm



Torque on screw: min. 0,6 Nm (6 kg cm)  
 max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.



**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	70 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	35 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	12 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	30 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	245 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

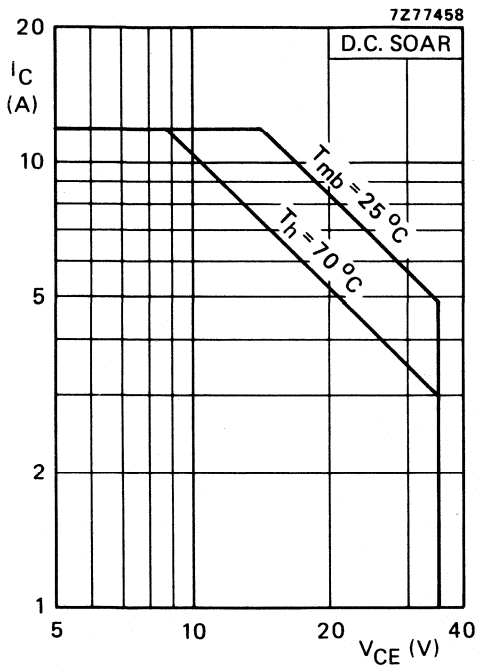


Fig. 2 D.C. SOAR.

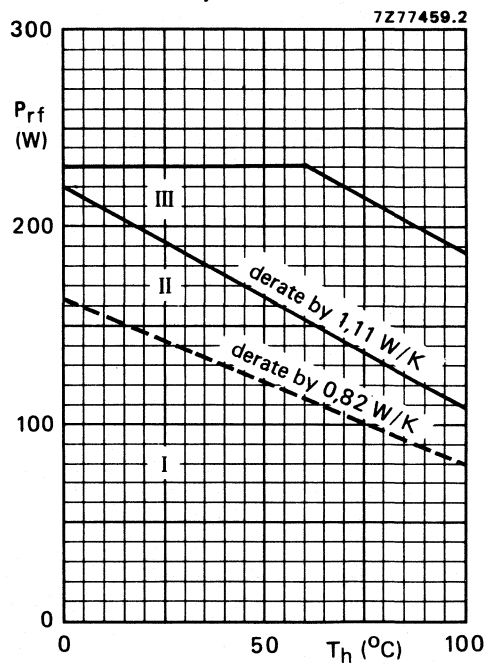


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f \geq 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 100 W;  $T_{mb} = 90$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	1,03 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	0,71 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,2 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 50\text{ mA}$

$V_{(BR)CES} > 70\text{ V}$

Collector-emitter breakdown voltage

open base;  $I_C = 100\text{ mA}$

$V_{(BR)CEO} > 35\text{ V}$

Emitter-base breakdown voltage

open collector;  $I_E = 20\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0; V_{CE} = 35\text{ V}$

$I_{CES} < 20\text{ mA}$

D.C. current gain\*

$I_C = 7\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE} \quad 15\text{ to }80$

D.C. current gain ratio of matched devices\*

$I_C = 7\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE1}/h_{FE2} < 1,2$

Collector-emitter saturation voltage\*

$I_C = 20\text{ A}; I_B = 4\text{ A}$

$V_{CEsat} \quad \text{typ. } 2\text{ V}$

Transition frequency at  $f = 100\text{ MHz}$ \*\*

$-I_E = 7\text{ A}; V_{CB} = 28\text{ V}$

$f_T \quad \text{typ. } 320\text{ MHz}$

$-I_E = 20\text{ A}; V_{CB} = 28\text{ V}$

$f_T \quad \text{typ. } 300\text{ MHz}$

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 28\text{ V}$

$C_C \quad \text{typ. } 255\text{ pF}$

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$

$C_{re} \quad \text{typ. } 175\text{ pF}$

Collector-flange capacitance

$C_{cf} \quad \text{typ. } 3\text{ pF}$

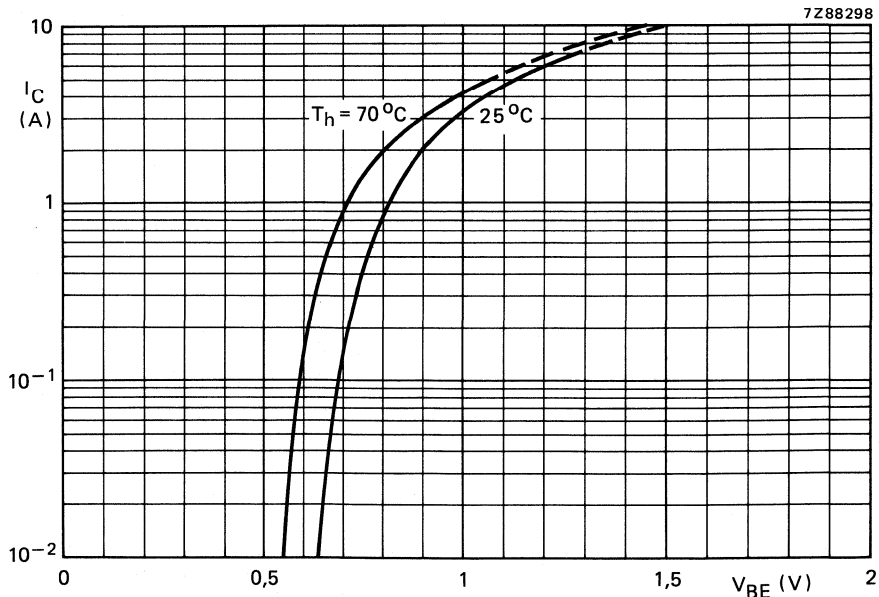


Fig. 4 Typical values;  $V_{CE} = 20\text{ V}$ .

\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0,02$ .

\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}; \delta \leq 0,01$ .

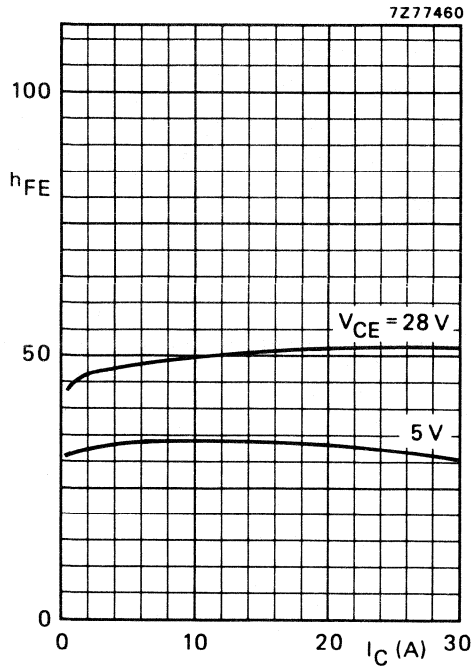


Fig. 5 Typical values;  $T_j = 25^\circ\text{C}$ .

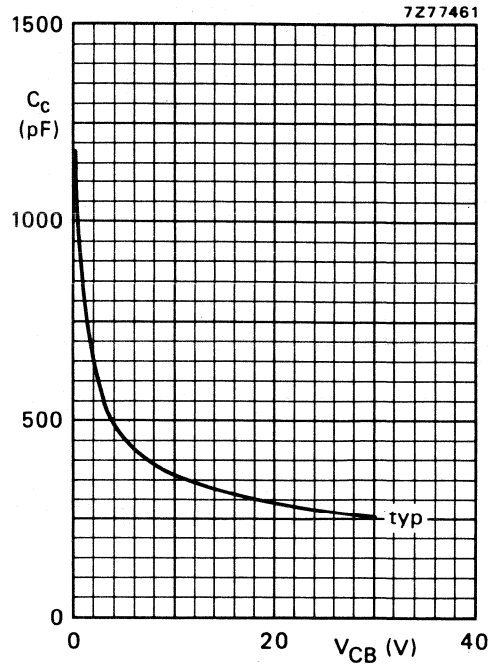


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

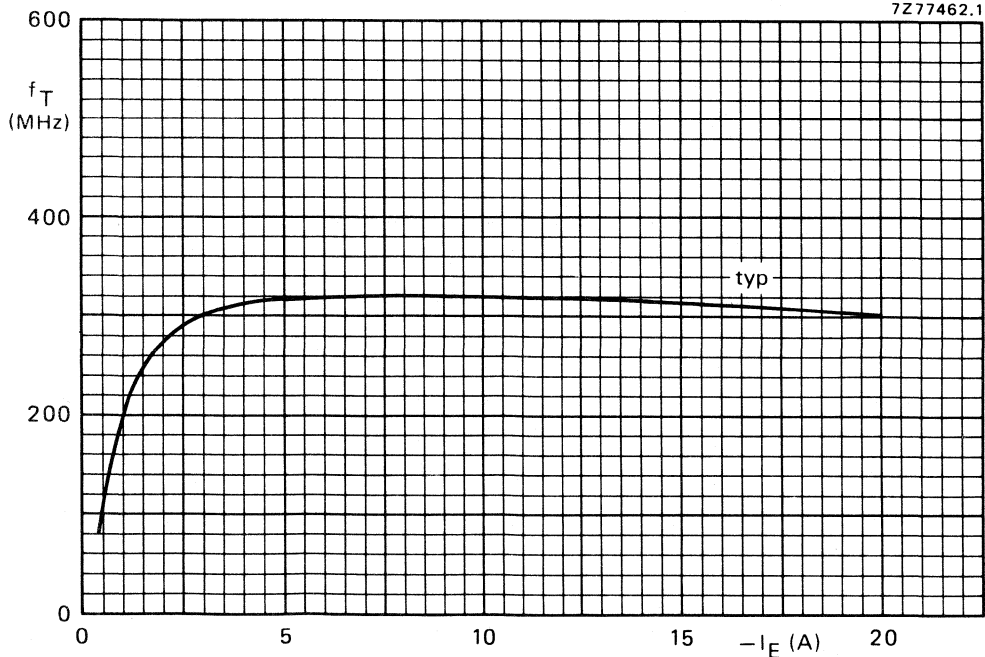


Fig. 7  $V_{CB} = 28\text{ V}$ ;  $f = 100\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in s.s.b. class-AB operation (linear power amplifier)

 $V_{CE} = 28 \text{ V}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$\eta_{dt}$ (%) at 130 W P.E.P.	$I_C$ (A)	$d_3$ dB	$d_5$ dB	$I_C$ (ZS) A
15 to 130 (P.E.P.)	> 12	> 37,5	< 6,2	< -30	< -30	0,1

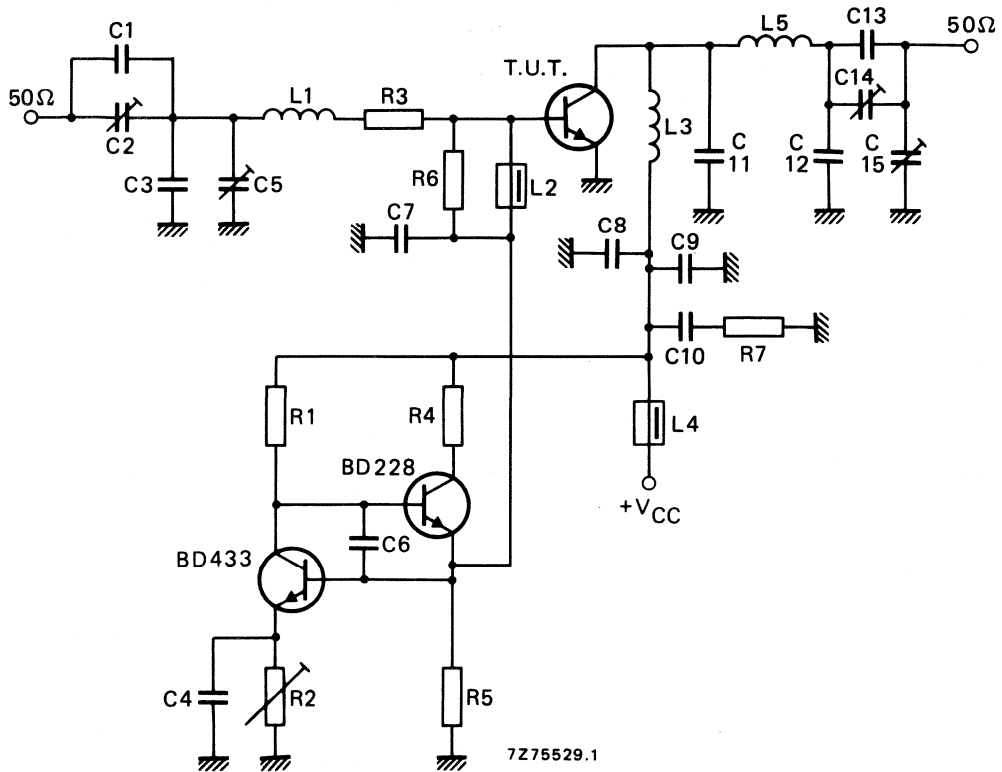


Fig. 8 Test circuit; s.s.b. class-AB.

## List of components:

- C1 = 27 pF ceramic capacitor (500 V)
- C2 = 100 pF air dielectric trimmer (single insulated rotor type)
- C3 = 180 pF polystyrene capacitor
- C4 = C6 = C9 = 100 nF polyester capacitor
- C5 = 100 pF air dielectric trimmer (single non-insulated rotor type)
- C7 = C8 = 3,9 nF ceramic capacitor
- C10 = 2,2  $\mu\text{F}$  moulded metallized polyester capacitor
- C11 = 2 x 180 pF polyester capacitors in parallel
- C12 = 3 x 56 pF and 33 pF ceramic capacitors in parallel (500 V)
- C13 = 4 x 56 pF and 68 pF ceramic capacitors in parallel (500 V)

C14 = 360 pF air dielectric trimmer (single insulated rotor type)

C15 = 360 pF air dielectric trimmer (single non-insulated rotor type)

L1 = 88 nH; 3 turns Cu wire (1,0 mm); int. dia. 9,0 mm; length 6,1 mm; leads 2 x 7 mm

L2 = L4 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L5 = 80 nH; 2,5 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 10,0 mm; leads 2 x 7 mm

R1 = 470  $\Omega$  wirewound resistor (5,5 W)

R2 = 4,7  $\Omega$  wirewound potentiometer (3 W)

R3 = 0,55  $\Omega$ ; parallel connection of 4 x 2,2  $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,5 W each)

R4 = 45  $\Omega$ ; parallel connection of 4 x 180  $\Omega$  wirewound resistors (5,5 W each)

R5 = 56  $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,5 W)

R6 = 27  $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,5 W)

R7 = 4,7  $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,5 W)

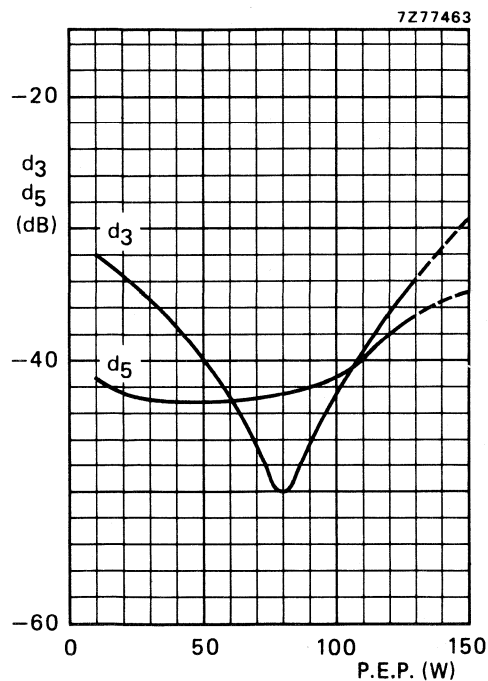


Fig. 9 Intermodulation distortion as a function of output power.\*

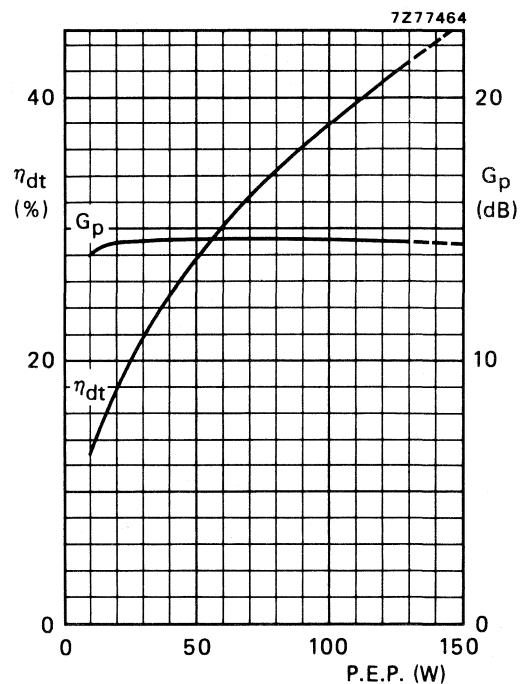


Fig. 10 Double-tone efficiency and power gain as a function of output power.

Conditions for Figs 9 and 10:

$V_{CE} = 28$  V;  $I_{C(ZS)} = 100$  mA;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  $T_h = 25$  °C; typical values.

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

APPLICATION INFORMATION (continued)

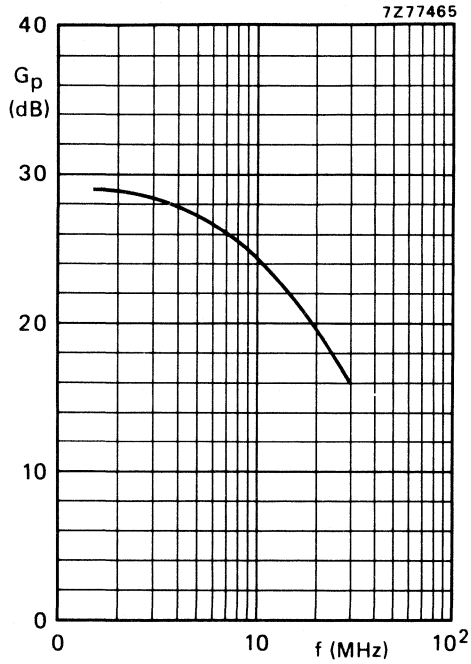


Fig. 11 Power gain as a function of frequency.

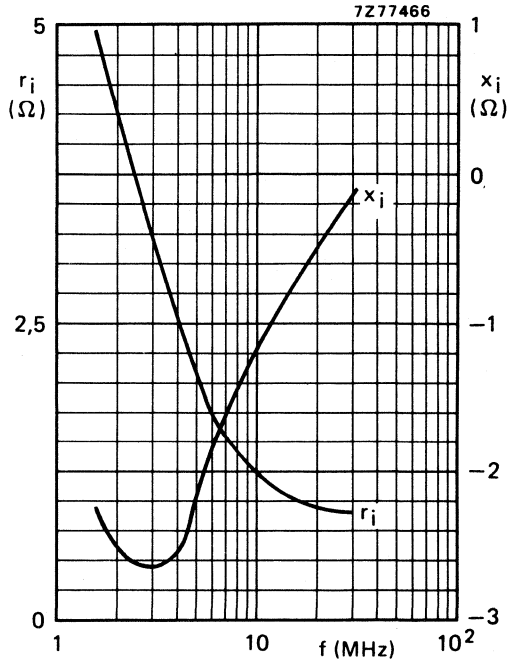


Fig. 12 Input impedance (series components) as a function of frequency.

Figs 11 and 12 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 100 \text{ mA}$ ;  $P_L = 130 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 2,5 \text{ } \Omega$ .

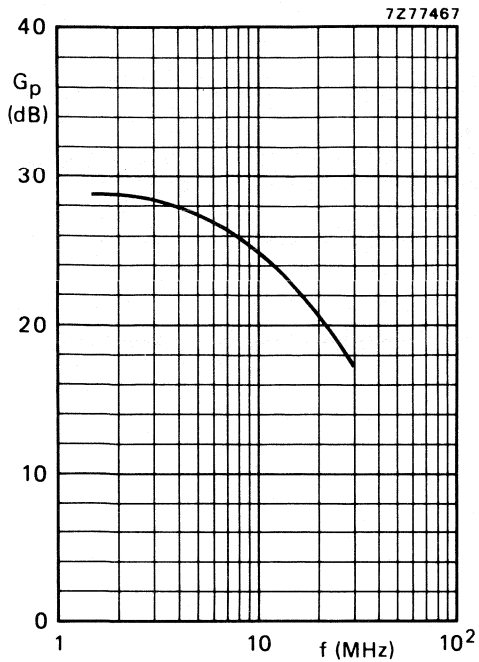


Fig. 13 Power gain as a function of frequency.

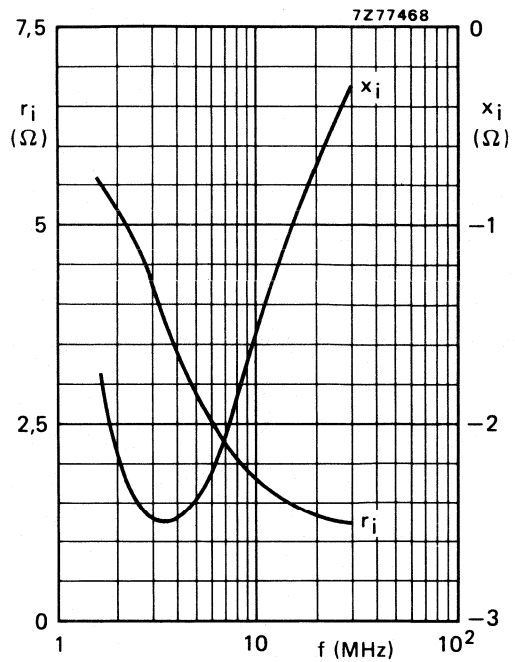


Fig. 14 Input impedance (series components) as a function of frequency.

Figs 13 and 14 are typical curves and hold for a push-pull amplifier with cross-neutralization in s.s.b class-AB operation.

Conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 100 \text{ mA}$ ;  $P_L = 130 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 2,5 \text{ } \Omega$ ; neutralizing capacitor: 150 pF.

APPLICATION INFORMATION (continued)

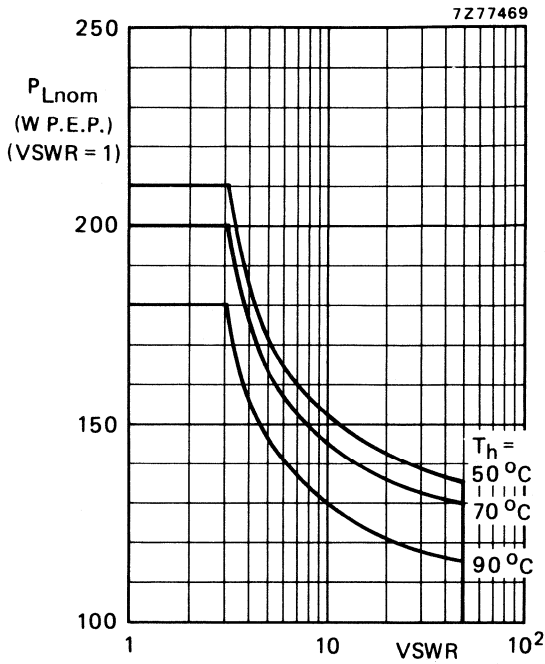


Fig. 15 R.F. SOAR; s.s.b. class-AB operation;  
 $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  $V_{CE} = 28$  V;  
 $R_{th\ mb-h} = 0,2$  K/W.  
 The graph shows the permissible output power under nominal conditions (VSWR = 1) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.



R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
87,5	28	130	typ. 23,2	typ. 7,5	typ. 6,2	typ. 75	$0,62 + j0,73$	$273 - j42$

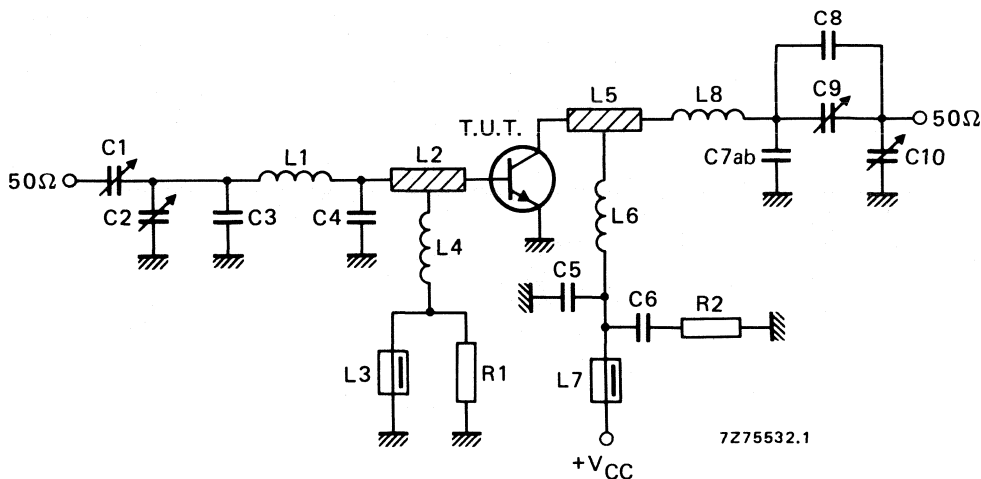


Fig. 16 Test circuit; c.w. class-B.

List of components:

C1 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C2 = C9 = C10 = 7 to 100 pF film dielectric trimmer (cat. no. 2222 809 07015)

C3 = C8 = 22 pF ceramic capacitor (500 V)

C4 = 4 x 82 pF ceramic capacitors in parallel (500 V)

C5 = 390 pF polystyrene capacitor

C6 = 220 nF polyester capacitor

C7a = 2 x 10 pF ceramic capacitors in parallel (500 V)

C7b = 2 x 8,2 pF ceramic capacitors in parallel (500 V)

L1 = 25 nH; 2 turns Cu wire (1,6 mm); int. dia. 5,0 mm; length 4,6 mm; leads 2 x 5 mm

L2 = L5 = 2,4 nH; strip (12 mm x 6 mm); tap for L4 and L6 at 5 mm from transistor

L3 = L7 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L6 = 46 nH; 2 turns Cu wire (2,0 mm); int. dia. 9,0 mm; length 6,0 mm; leads 2 x 5 mm

L8 = 44 nH; 2 turns Cu wire (2,0 mm); int. dia. 9,0 mm; length 6,7 mm; leads 2 x 5 mm

L2 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric.

R1 = 10  $\Omega$  ( $\pm 10\%$ ) carbon resistorR2 = 4,7  $\Omega$  ( $\pm 10\%$ ) carbon resistor

Component layout and printed-circuit board for 87,5 MHz test circuit are shown in Fig. 17.

## APPLICATION INFORMATION (continued)

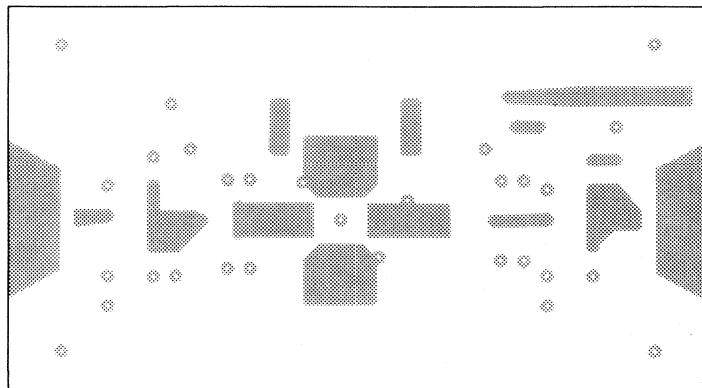
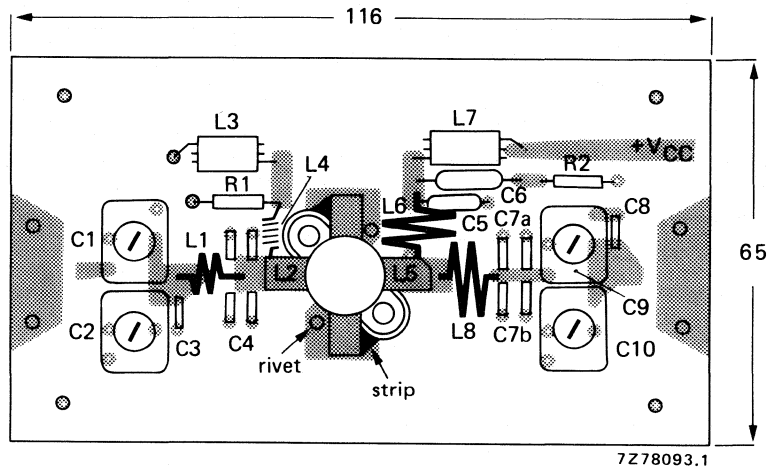


Fig. 17 Component layout and printed-circuit board for 87,5 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

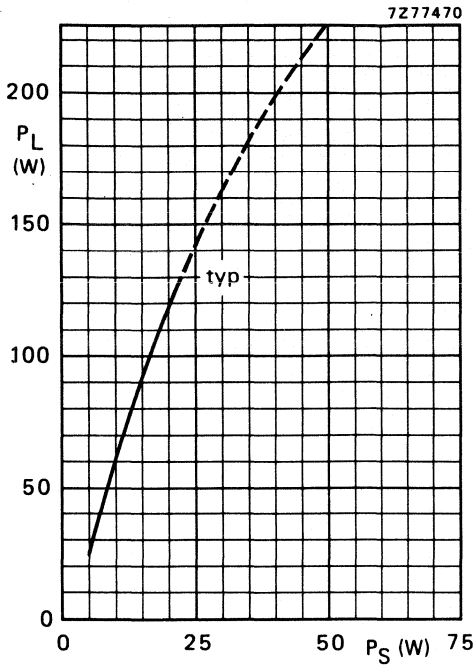


Fig. 18  $V_{CE} = 28$  V;  $f = 87,5$  MHz;  $T_h = 25$  °C.

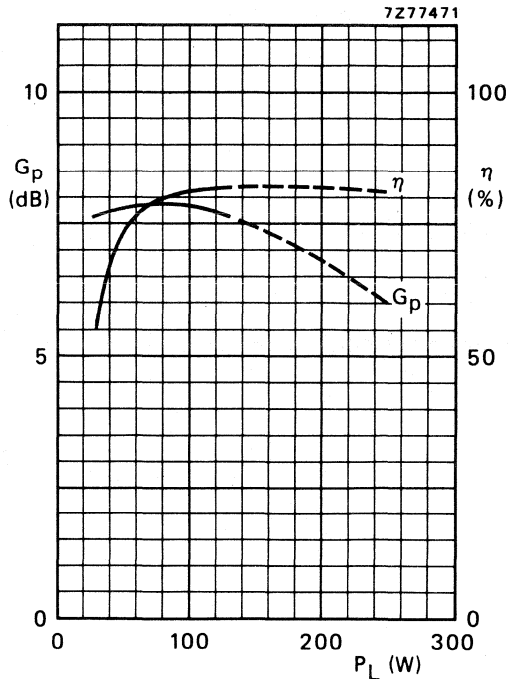


Fig. 19  $V_{CE} = 28$  V;  $f = 87,5$  MHz;  $T_h = 25$  °C; typical values.

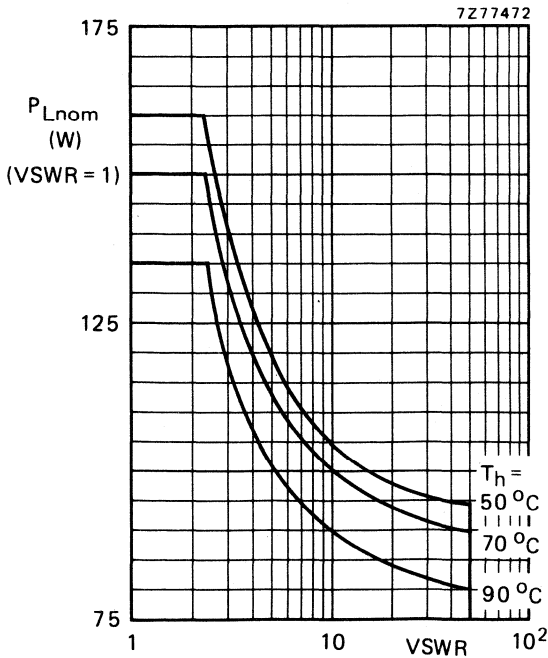


Fig. 20 R.F. SOAR; c.w. class-B operation;  $f = 87,5$  MHz;  $V_{CE} = 28$  V;  $R_{th\ mb-h} = 0,2$  K/W. The graph shows the permissible output power under nominal conditions (VSWR = 1) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

APPLICATION INFORMATION (continued)

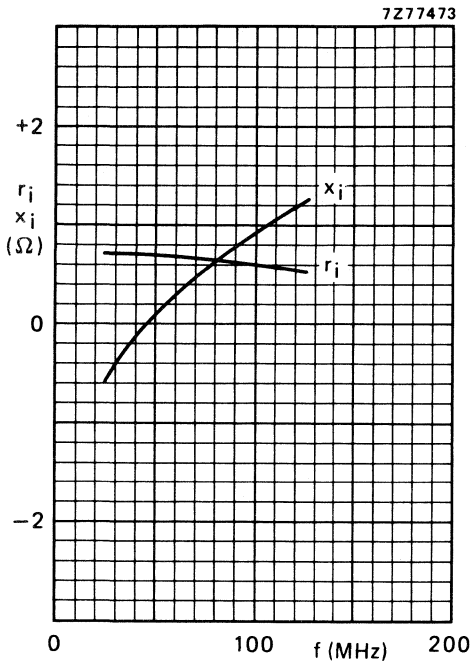


Fig. 21  $V_{CE} = 28 \text{ V}$ ;  $P_L = 130 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; typical values.

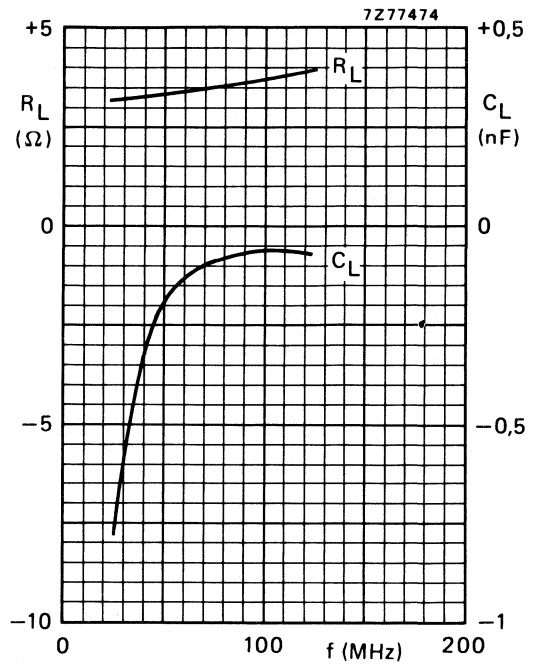


Fig. 22  $V_{CE} = 28 \text{ V}$ ;  $P_L = 130 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; typical values.

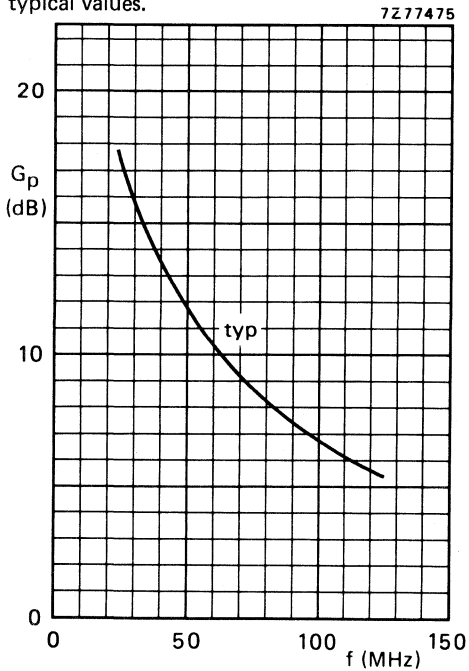


Fig. 23  $V_{CE} = 28 \text{ V}$ ;  $P_L = 130 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, AB or B operated mobile, industrial and military transmitters in the h.f. and v.h.f. bands. It is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

It has a ½" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	$I_C$ $I_{C(ZS)}$ A	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$d_3^*$ dB
c.w. (class-B)	28	—	150	100	> 6	> 70	—
s.s.b. (class-A)	26	3	28	35 (P.E.P.)	typ. 19,5	—	typ. -40
s.s.b. (class-AB)	28	0,05	28	100 (P.E.P.)	typ. 19,0	typ. 42	typ. -30

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

### MECHANICAL DATA

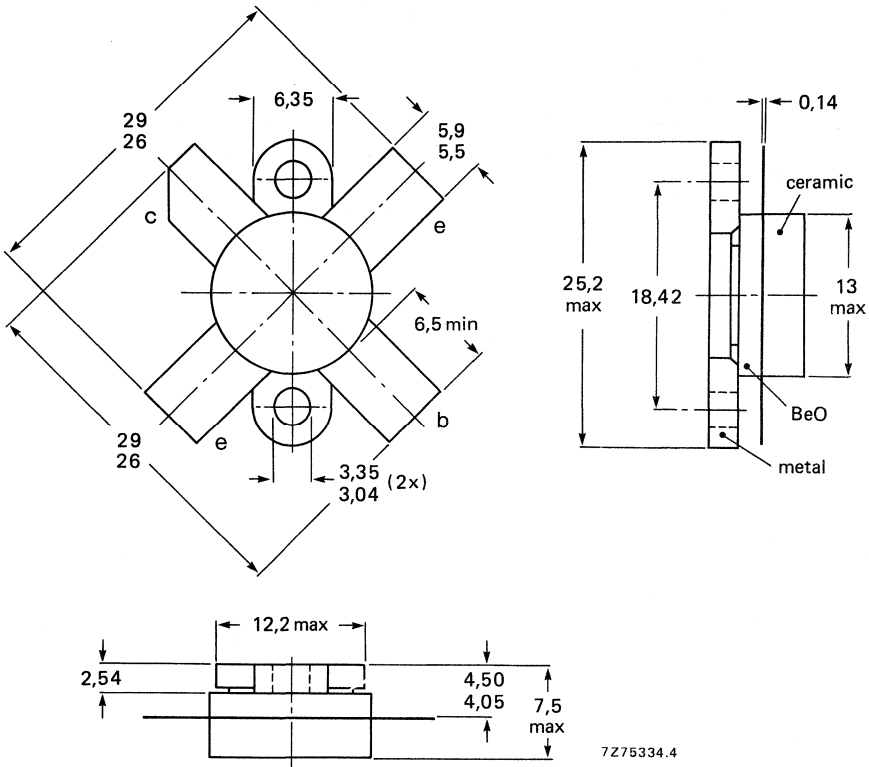
SOT-121 (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-121.

Dimensions in mm



Torque on screw: min. 0,6 Nm (6 kg cm)  
 max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value

$V_{CESM}$  max. 70 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 35 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_C(AV)$  max. 10 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 25 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 160 W

Storage temperature

$T_{stg}$  -65 to +150 °C

Operating junction temperature

$T_j$  max. 200 °C

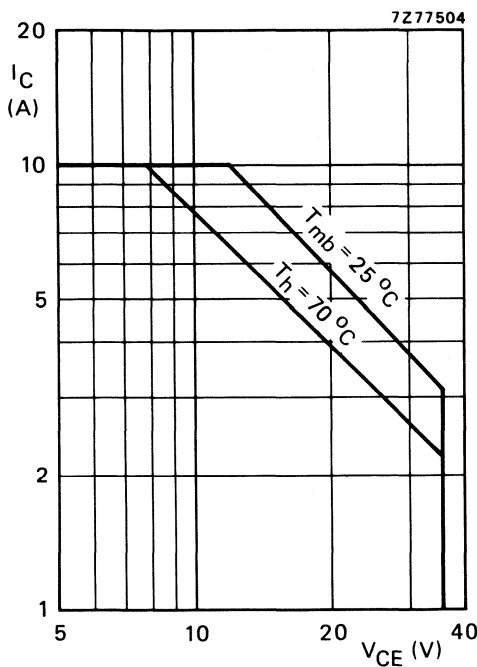


Fig. 2 D.C. SOAR.

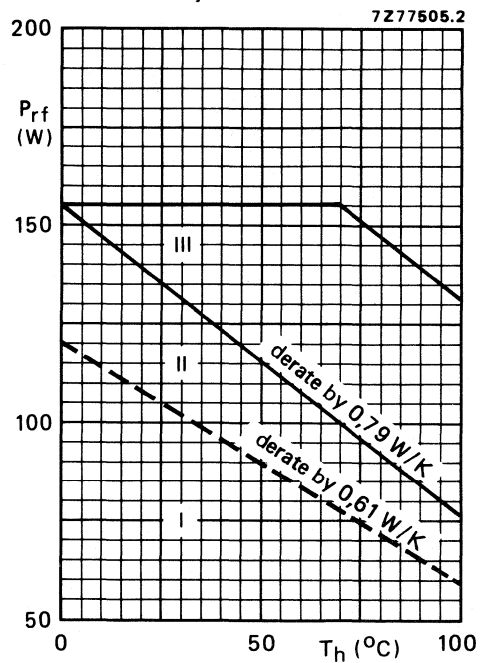


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 80 W;  $T_{mb} = 86$  °C; i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th j-mb(dc)}$  = 1,45 K/W

From junction to mounting base (r.f. dissipation)

$R_{th j-mb(rf)}$  = 1,06 K/W

From mounting base to heatsink

$R_{th mb-h}$  = 0,2 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 50\text{ mA}$  $V_{(BR)CES} > 70\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 100\text{ mA}$  $V_{(BR)CEO} > 35\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 5\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 35\text{ V}$  $I_{CES} < 5\text{ mA}$ 

D.C. current gain\*

 $I_C = 5\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE} \text{ 20 to 85}$ 

Collector-emitter saturation voltage

 $I_C = 15\text{ A}; I_B = 3\text{ A}$  $V_{CEsat} \text{ typ. } 2\text{ V}$ Transition frequency at  $f = 100\text{ MHz}^{**}$  $-I_E = 5\text{ A}; V_{CB} = 28\text{ V}$  $f_T \text{ typ. } 370\text{ MHz}$  $-I_E = 15\text{ A}; V_{CB} = 28\text{ V}$  $f_T \text{ typ. } 350\text{ MHz}$ Collector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_C \text{ typ. } 155\text{ pF}$ Feedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re} \text{ typ. } 102\text{ pF}$ 

Collector-flange capacitance

 $C_{cf} \text{ typ. } 3\text{ pF}$ \* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0,02$ .\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}; \delta \leq 0,01$ .



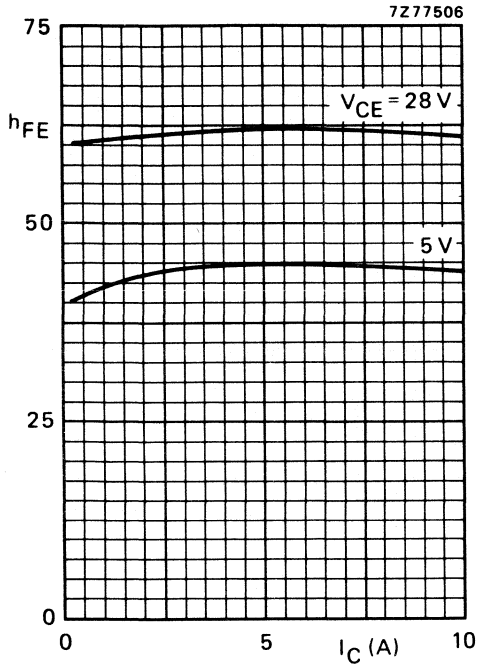


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

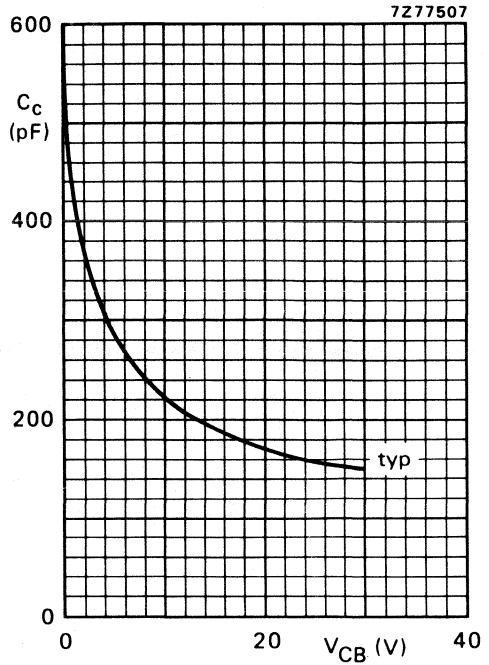


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

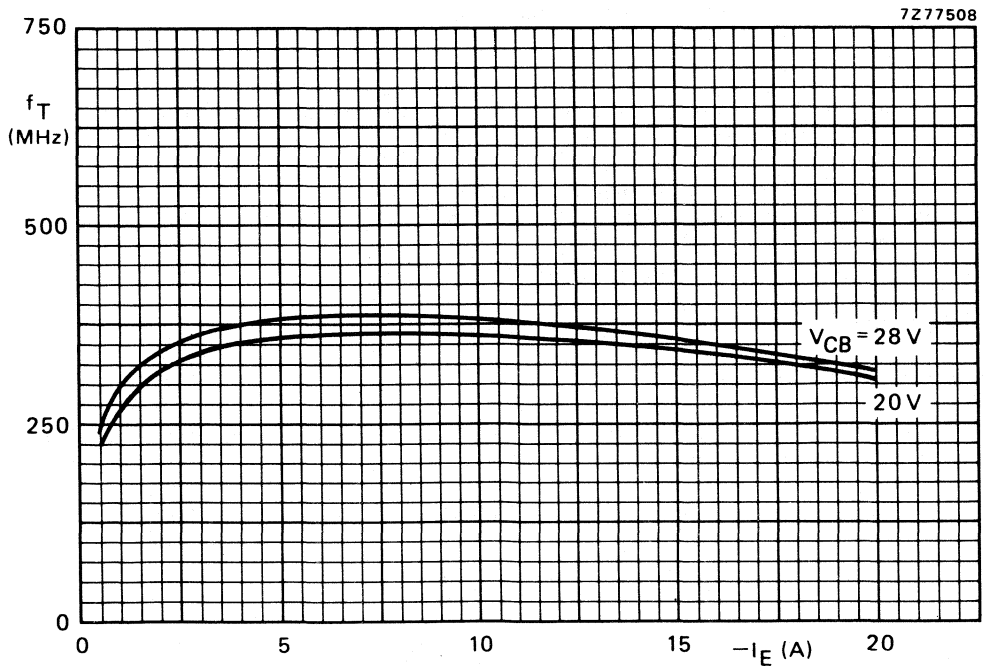


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit);  $T_h = 25\text{ }^\circ\text{C}$

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_D$ (W)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{z}_L$ ( $\Omega$ )
150	28	100	$\leq 25$	$\geq 70$	$0,74 + j1,35$	$4,30 + j0,60$

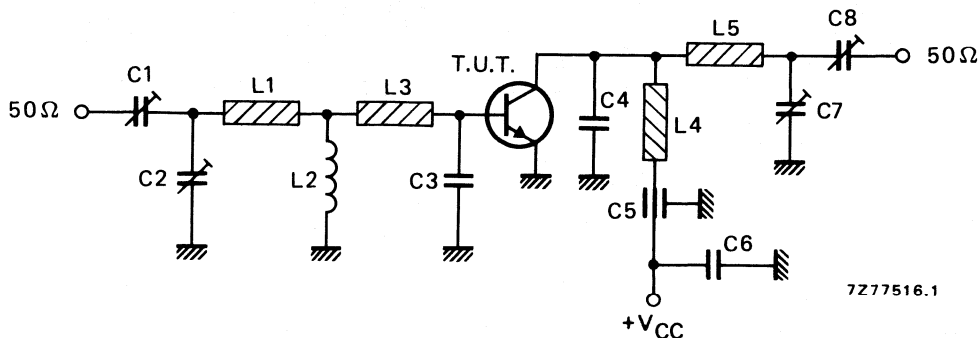


Fig. 7 Test circuit; c.w. class-B;  $f = 150\text{ MHz}$ .

List of components:

$C1 = C2 = C7 = C8 = 5$  to  $100\text{ pF}$  film dielectric trimmer

$C3 = 203\text{ pF}$ ;  $2 \times 82\text{ pF}$  and  $39\text{ pF}$  multilayer ceramic chip capacitors ( $500\text{ V}$ , ATC<sup>▲</sup>) in parallel

$C4 = 39\text{ pF}$  multilayer ceramic chip capacitor ( $500\text{ V}$ , ATC<sup>▲</sup>)


$C5 = 1\text{ nF}$  feed-through capacitor

$C6 = 100\text{ nF}$  polyester capacitor

$L1 =$  strip ( $30\text{ mm} \times 8\text{ mm}$ ); bent to form inverted 'U' shape with top  $15\text{ mm}$  above heatsink, and bottom  $5\text{ mm}$  above heatsink

$L2 = 1\text{ }\mu\text{H}$  r.f. choke

$L3 =$  strip; shape as shown in Fig. 8;  $5\text{ mm}$  above heatsink

$L4 =$  strip ( $40\text{ mm} \times 8\text{ mm}$ ); bent in form ,  $25\text{ mm}$  at  $15\text{ mm}$  above heatsink,  $5\text{ mm}$  at  $5\text{ mm}$  above heatsink

$L5 =$  strip ( $75\text{ mm}$  long; width  $8\text{ mm}$ );  $5\text{ mm}$  above base

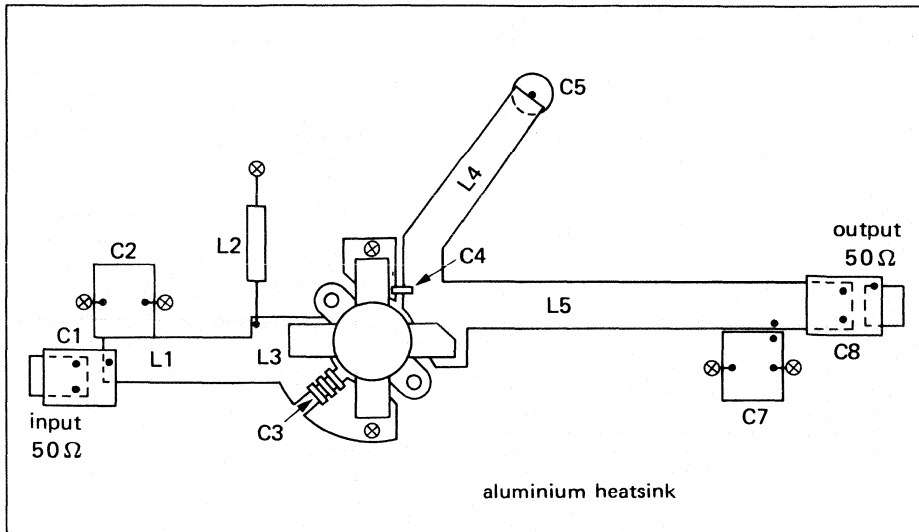
$L1$ ,  $L3$ ,  $L4$ , and  $L5$  are copper strips with a thickness of  $0,6\text{ mm}$ .

Heatsink: aluminium;  $0,9\text{ K/W}$

At  $P_L = 100\text{ W}$  and  $V_{CE} = 28\text{ V}$ , the output power at heatsink temperatures between  $25\text{ }^\circ\text{C}$  and  $90\text{ }^\circ\text{C}$  relative to that at  $25\text{ }^\circ\text{C}$  is diminished by typ.  $0,12\text{ W/K}$ .

Component layout on an aluminium heatsink for  $150\text{ MHz}$  test circuit is shown in Fig. 8.

<sup>▲</sup> ATC means American Technical Ceramics.



7277518

Fig. 8 Component layout on an aluminium heatsink for 150 MHz test circuit. ⊗ Earthing bolts.

APPLICATION INFORMATION (continued)

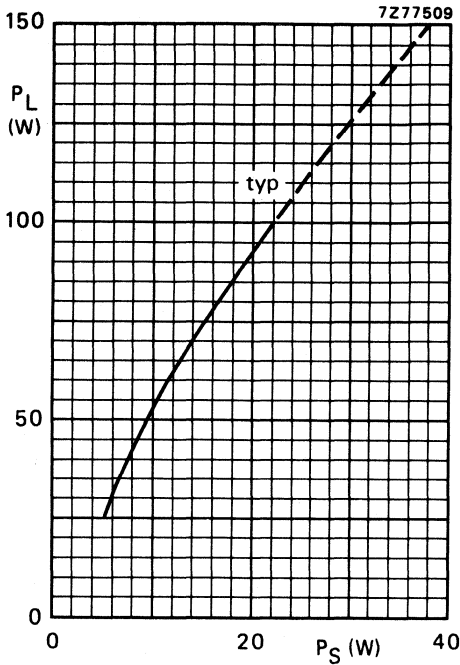


Fig. 9  $V_{CE} = 28 \text{ V}$ ;  $f = 150 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

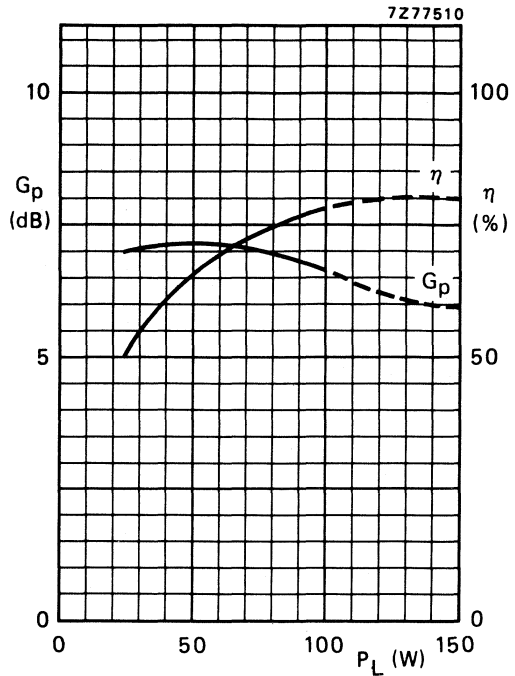


Fig. 10  $V_{CE} = 28 \text{ V}$ ;  $f = 150 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; typical values.

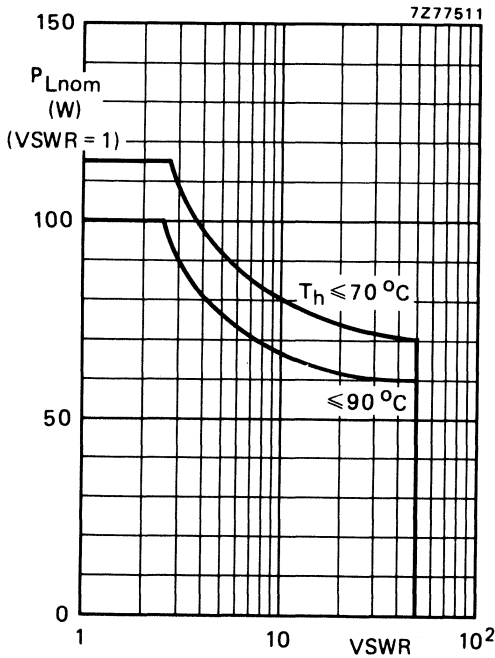


Fig. 11 R.F. SOAR; c.w. class-B operation;  $f = 150 \text{ MHz}$ ;  $V_{CE} = 28 \text{ V}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ . The graph shows the permissible output power under nominal conditions (VSWR = 1) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

**OPERATING NOTE** Below 50 MHz a base-emitter resistor of  $4,7 \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

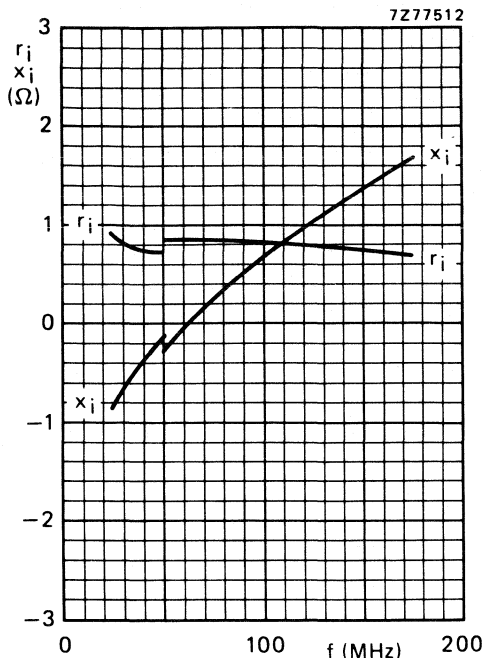


Fig. 12 Input impedance (series components).

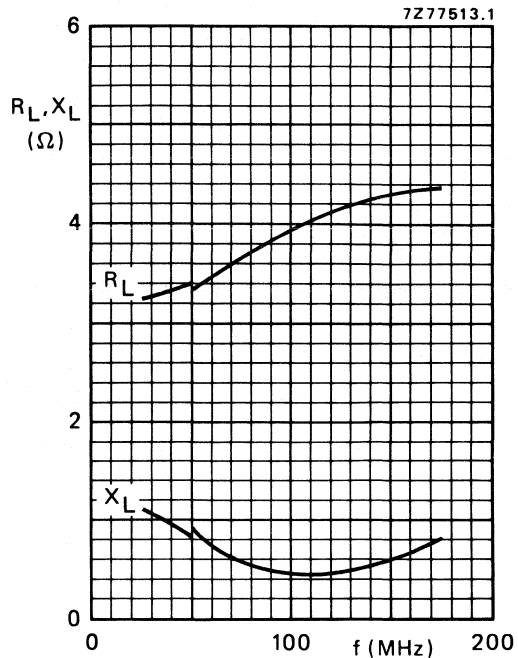
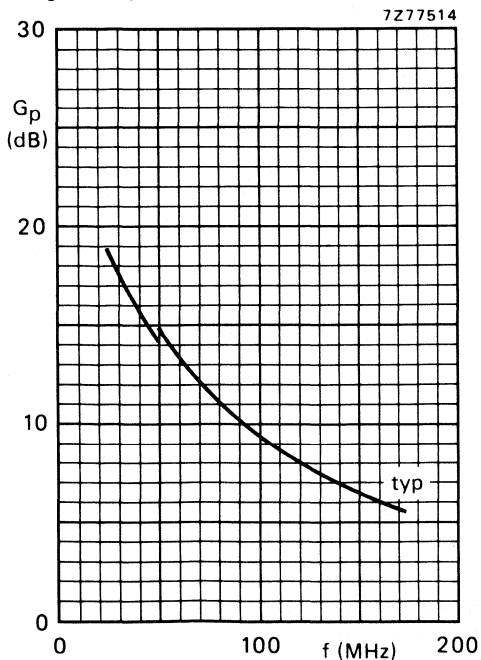


Fig. 13 Load impedance (series components).



Conditions for Figs 12, 13 and 14:  
 $V_{CE} = 28 \text{ V}$ ;  $P_L = 100 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  
 typical values; class-B operation.

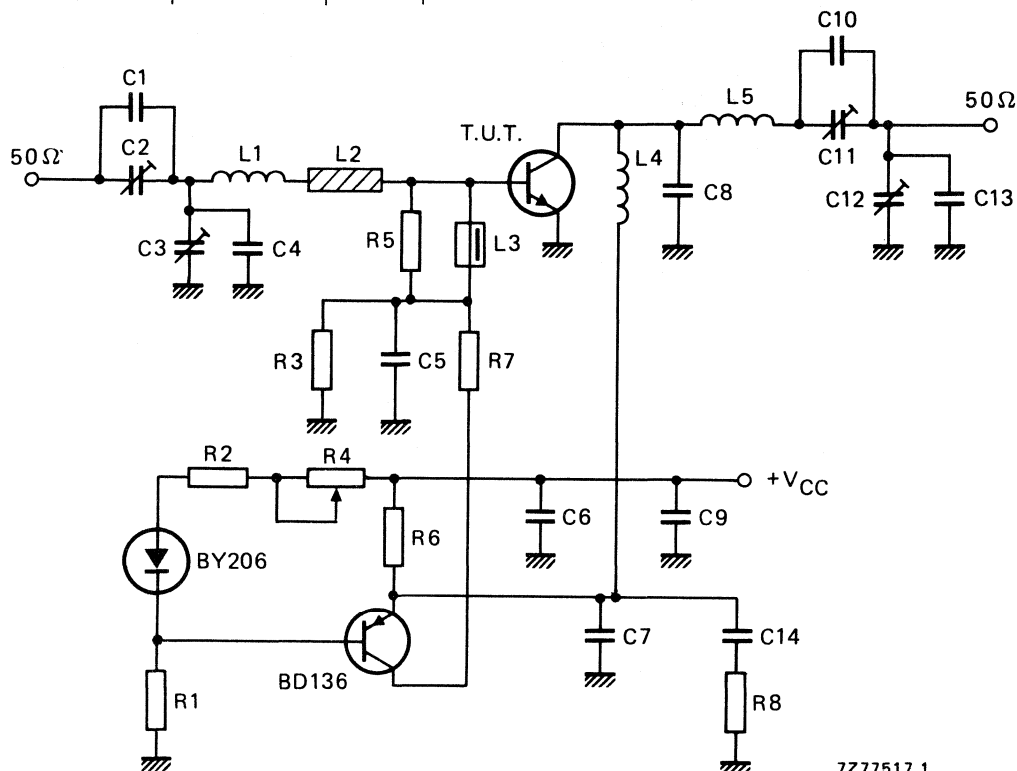
Fig. 14.

## APPLICATION INFORMATION (continued)

R.F. performance in s.s.b. class-A operation

 $V_{CE} = 26 \text{ V}$ ;  $T_h = 40 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$I_C$ A	$d_3$ dB
35 (P.E.P.)	typ. 19,5	3	typ. -40

Fig. 15 Test circuit; s.s.b. class-A;  $f = 28 \text{ MHz}$ .

## List of components:

- C1 = 33 pF ceramic capacitor (500 V)
- C2 = 100 pF air dielectric trimmer (single insulated rotor type)
- C3 = 280 pF air dielectric trimmer (single non-insulated rotor type)
- C4 = 180 pF polystyrene capacitor
- C5 = C6 = C7 = 3,9 nF ceramic capacitor
- C8 = 2 x 33 pF ceramic capacitors in parallel (500 V)
- C9 = 330 nF polyester capacitor
- C10 = 82 pF ceramic capacitor (500 V)
- C11 = 100 pF air dielectric trimmer (single insulated rotor type)
- C12 = 180 pF air dielectric trimmer (single non-insulated rotor type)
- C13 = 150 pF polystyrene capacitor
- C14 = 390 nF polyester capacitor

List of components in Fig. 15 (continued):

L1 = 72 nH; 3 turns Cu wire (1,0 mm); int. dia. 7 mm; length 4,8 mm; leads 2 x 5 mm

L2 = Cu strip (28 mm x 5 mm x 0,2 mm); 18 mm at 3 mm above printed-circuit board

L3 = Ferroxcube choke coil (cat. no. 4312 020 36640)

L4 = 300 nH; 6 turns Cu wire (1,5 mm); int. dia. 12 mm; length 16 mm; leads 2 x 5 mm

L5 = 330 nH; 7 turns Cu wire (1,5 mm); int. dia. 12 mm; length 20,8 mm; leads 2 x 5 mm

R1 = 1,5 k $\Omega$  ( $\pm$  5%) carbon resistor (0,5 W)

R2 = 100  $\Omega$  ( $\pm$  5%) carbon resistor (0,5 W)

R3 = 68  $\Omega$  ( $\pm$  5%) carbon resistor (0,5 W)

R4 = 100  $\Omega$  wirewound potentiometer

R5 = 33  $\Omega$  ( $\pm$  5%) carbon resistor (0,5 W)

R6 = 0,68  $\Omega$  ( $\pm$  10%) wirewound resistor (7 W)

R7 = 120  $\Omega$  wirewound resistor (8 W)

R8 = 10  $\Omega$  ( $\pm$  10%) carbon resistor (0,5 W)

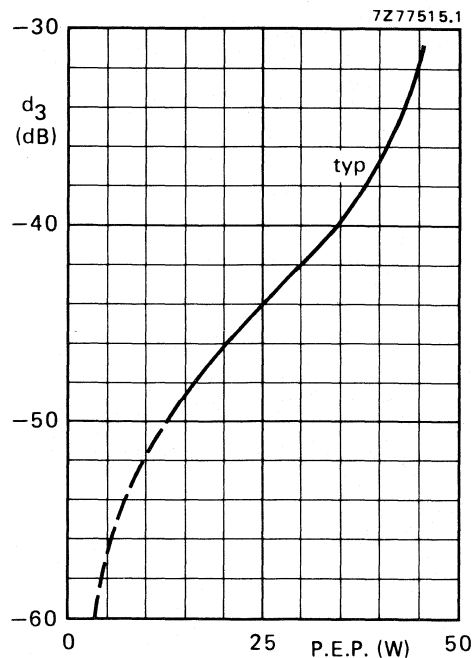


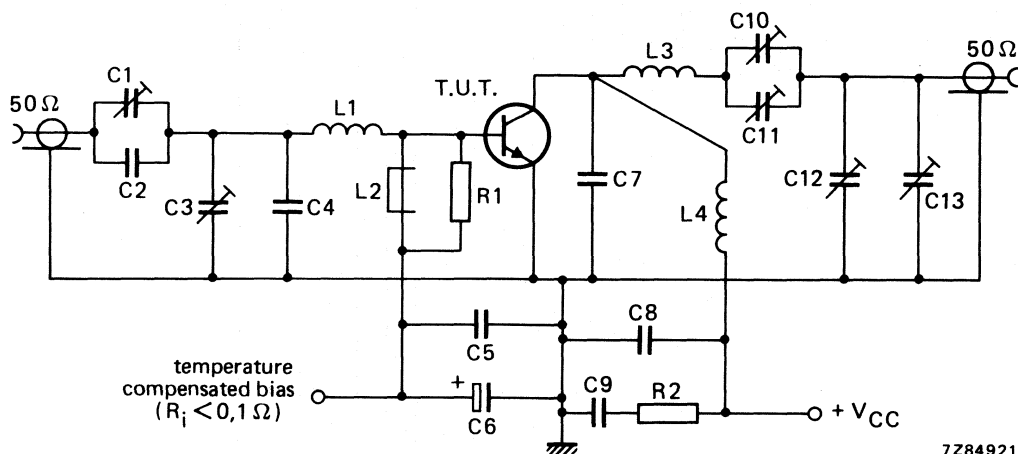
Fig. 16 Intermodulation distortion as a function of output power;  $V_{CE} = 26$  V;  $I_C = 3$  A;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  $T_h = 40$   $^{\circ}$ C.

## APPLICATION INFORMATION (continued)

R.F. performance in s.s.b. class-AB operation (linear power amplifier)

 $V_{CE} = 28 \text{ V}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$\eta_{dt}$ %	$I_C$ A	$d_3^*$ dB	$d_5^*$ dB	$I_{C(ZS)}$ mA
100 (P.E.P.)	typ. 19	typ. 42	typ. 4,3	typ. -30	typ. -37	50

Fig. 17 Test circuit; s.s.b. class-AB;  $f = 28 \text{ MHz}$ .

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## List of components:

- C1 = C11 = 150 pF air dielectric trimmer (single insulated rotor type)
- C2 = 27 pF ceramic capacitor (500 V)
- C3 = C12 = 150 pF air dielectric trimmer (single non-insulated rotor type)
- C4 = 180 pF ceramic capacitor (500 V)
- C5 = C8 = 3,9 nF ceramic capacitor
- C6 = 150  $\mu\text{F}/6 \text{ V}$  solid tantalum capacitor
- C7 = 150 pF ceramic capacitor (500 V)
- C9 = 100 nF polyester capacitor
- C10 = 750 pF mica dielectric trimmer (single insulated rotor type)
- C13 = 750 pF mica dielectric trimmer (single non-insulated rotor type)
- L1 = 3 turns enamelled Cu wire (1,0 mm); int. dia. 12 mm; length 12 mm
- L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)
- L3 = 3 turns enamelled Cu wire (2,0 mm); int. dia. 12 mm; length 12 mm
- L4 = 2 turns enamelled Cu wire (2,0 mm); int. dia. 12 mm; length 8 mm
- R1 = 27  $\Omega$  ( $\pm 10\%$ ) carbon resistor (0,5 W)
- R2 = 4,7  $\Omega$  ( $\pm 10\%$ ) carbon resistor (0,5 W)

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.



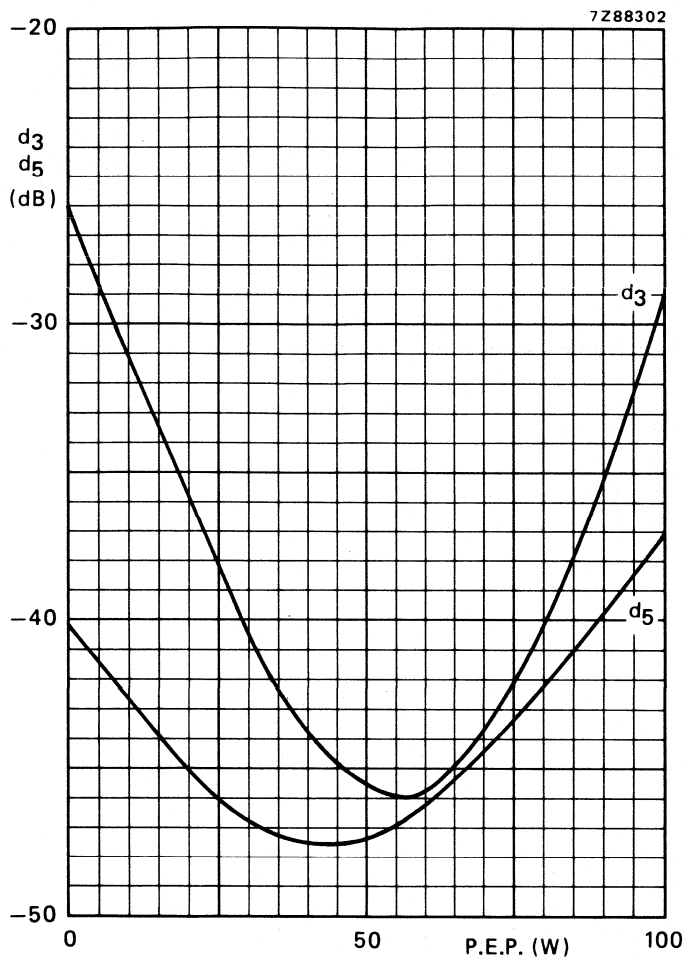


Fig. 18 Intermodulation distortion\* as a function of output power.  
Typical values;  $V_{CE} = 28$  V;  $I_{C(ZS)} = 50$  mA;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  $T_h = 25$  °C.

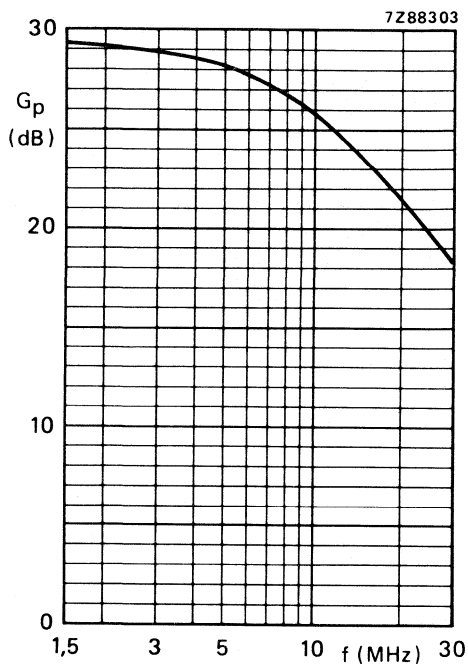


Fig. 19 Power gain as a function of frequency.

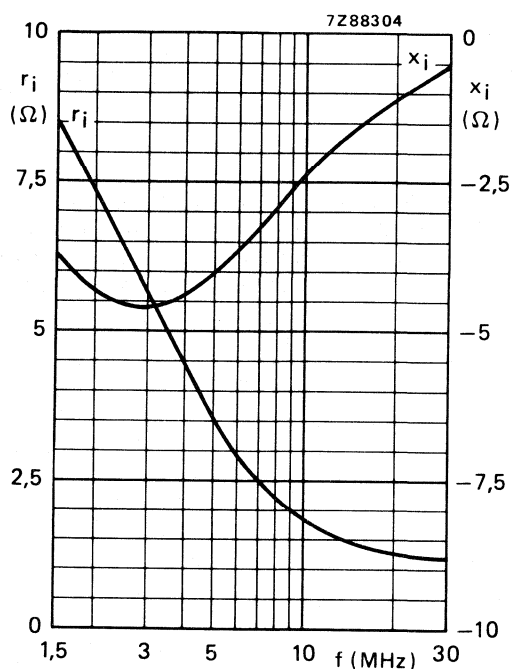


Fig. 20 Input impedance (series components).

Figs 19 and 20 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.  
 Conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $P_L = 100 \text{ W (P.E.P.)}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 2,7 \text{ } \Omega$ .

## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for transmitting applications in class-A, B or C in the u.h.f. and v.h.f. range for nominal supply voltages up to 13,5 V. The resistance stabilization of the transistor provides protection against device damage at severe load mismatch conditions. The transistor is housed in a ¼" capstan envelope with a ceramic cap.

### QUICK REFERENCE DATA

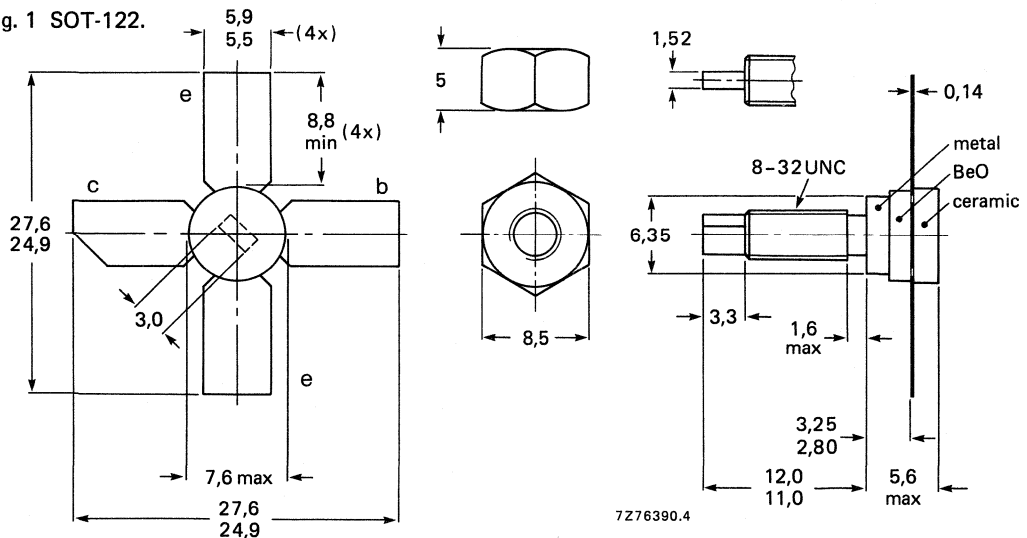
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CC}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	12,5	470	2	> 9,0	> 60	$3,5 + j0,4$	$28 - j38$
c.w.	12,5	175	2	typ. 13,5	typ. 60	$4,2 - j3,4$	$25 - j24$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-emitter voltage ( $V_{BE} = 0$ )

peak value

$V_{CESM}$  max 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max 17 V

Emitter-base voltage (open collector)

$V_{EBO}$  max 4 V

Collector current (d.c.)

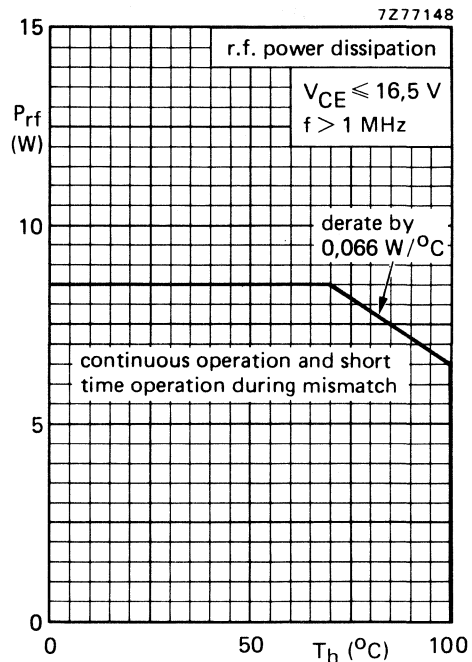
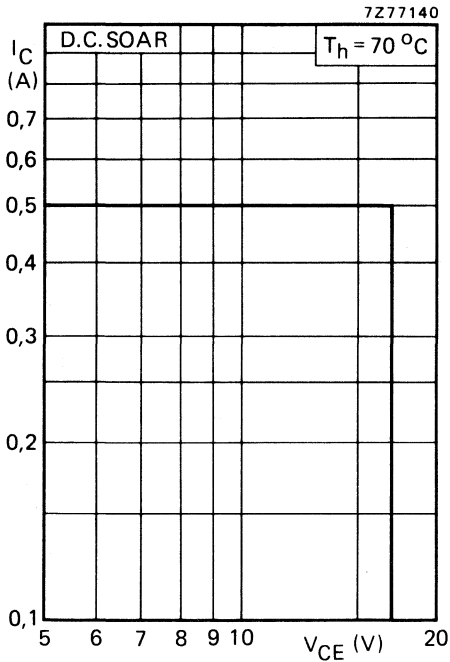
$I_C$  max 0,5 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max 1,5 A

Total power dissipation (d.c. and r.f.) up to  $T_h = 70$  °C

$P_{tot}$  max 8,5 W



Storage temperature

$T_{stg}$  -65 to +150 °C

Operating junction temperature

$T_j$  max 200 °C

**THERMAL RESISTANCE**

From junction to mounting base

$R_{th\ j-mb}$  = 14,5 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,6 K/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$ **Breakdown voltages**

Collector-emitter voltage

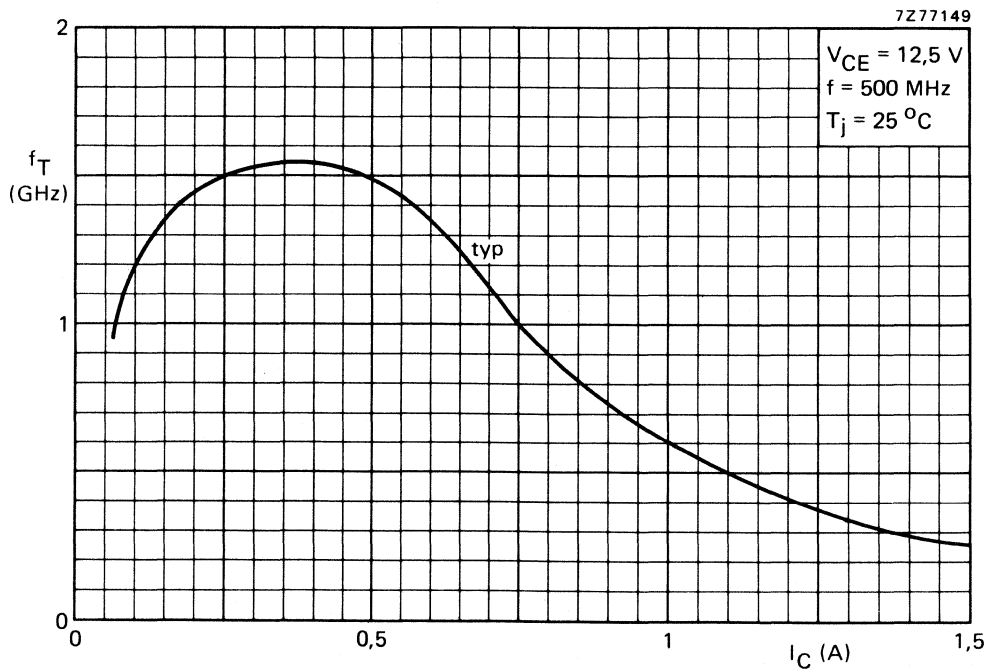
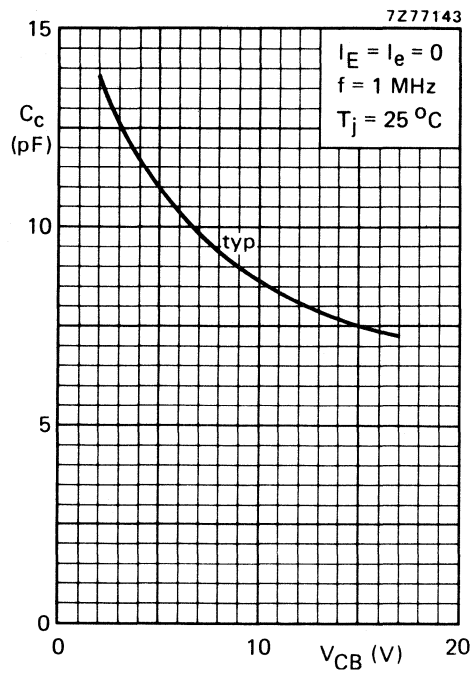
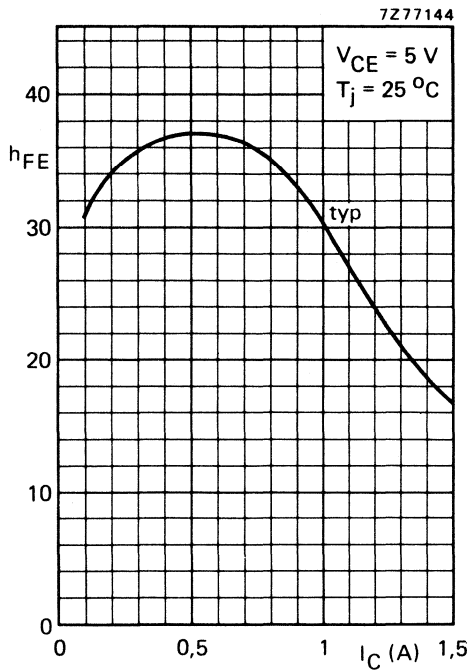
 $V_{BE} = 0; I_C = 5\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter voltage

open base;  $I_C = 25\text{ mA}$  $V_{(BR)CEO} > 17\text{ V}$ 

Emitter-base voltage

open collector;  $I_E = 2\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ **Collector cut-off current** $V_{BE} = 0; V_{CE} = 17\text{ V}$  $I_{CES} < 2\text{ mA}$ **D.C. current gain \*** $I_C = 250\text{ mA}; V_{CE} = 5\text{ V}$  $h_{FE} > \text{typ } 10$   
 $35$ **Collector-emitter saturation voltage \*** $I_C = 750\text{ mA}; I_B = 150\text{ mA}$  $V_{CEsat} \text{ typ } 0,6\text{ V}$ **Transition frequency at  $f = 500\text{ MHz}$  \*** $I_C = 250\text{ mA}; V_{CE} = 12,5\text{ V}$  $f_T \text{ typ } 1,5\text{ GHz}$  $I_C = 750\text{ mA}; V_{CE} = 12,5\text{ V}$  $f_T \text{ typ } 1,0\text{ GHz}$ **Collector capacitance at  $f = 1\text{ MHz}$**  $I_E = I_e = 0; V_{CB} = 12,5\text{ V}$  $C_C \text{ typ } 8\text{ pF}$ **Feedback capacitance at  $f = 1\text{ MHz}$**  $I_C = 20\text{ mA}; V_{CE} = 12,5\text{ V}$  $C_{re} \text{ typ } 3,6\text{ pF}$ **Collector-stud capacitance** $C_{cs} \text{ typ } 1,2\text{ pF}$ \* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .



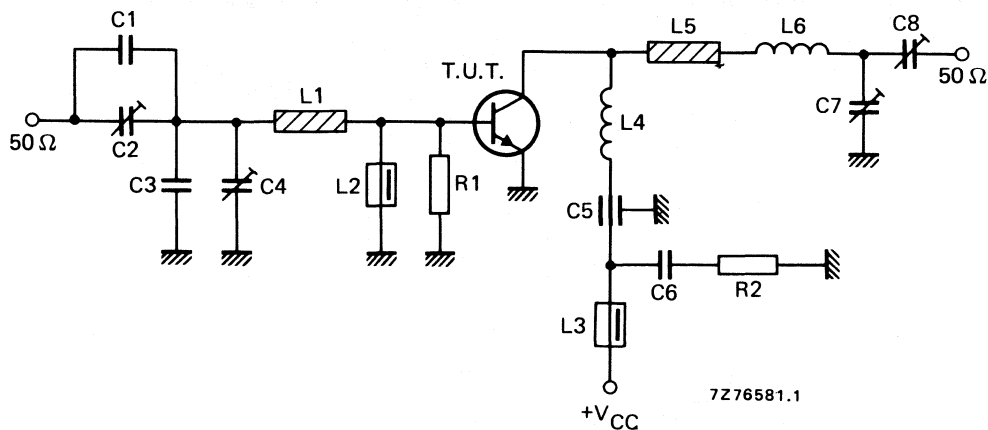
## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
470	12,5	2	< 0,25 >	9,0	< 0,27 >	60	$3,5 + j0,4$	$28 - j38$
470	13,5	2	—	typ 10,5	—	typ 70	—	—
175	12,5	2	—	typ 13,5	—	typ 60	$4,2 - j3,4$	$25 - j24$

Test circuit for 470 MHz



List of components:

C1 = 2,2 pF ( $\pm 0,25$  pF) ceramic capacitor

C2 = C4 = C7 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C3 = 3,3 pF ( $\pm 0,25$  pF) ceramic capacitor

C5 = 100 pF ceramic feed-through capacitor

C6 = 100 nF polyester capacitor

C8 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)

L1 = stripline (35,6 mm x 6,0 mm)

L2 = L3 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = 178 nH; 4 turns Cu wire (1 mm); int. dia. 6 mm; length 7 mm; leads 2 x 5 mm

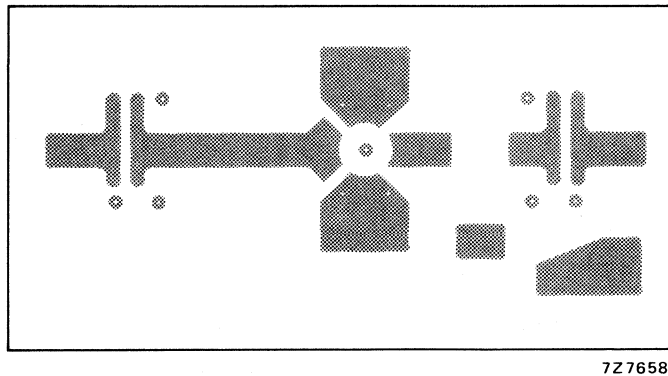
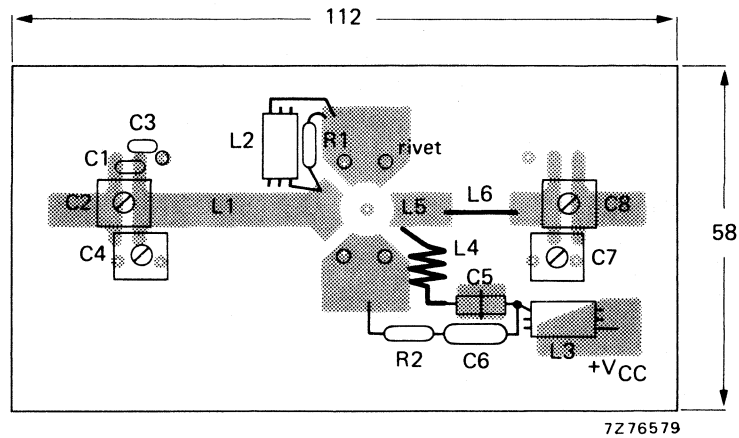
L5 = stripline (10,0 mm x 6,0 mm)

L6 = 28 nH;  $\frac{1}{2}$  turn Cu wire (1 mm); int. dia. 10 mmL1 and L5 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness  $1/16''$ .R1 = 100  $\Omega$  ( $\pm 5\%$ ) carbon resistorR2 = 10  $\Omega$  ( $\pm 5\%$ ) carbon resistor

Component layout and printed-circuit board for 470 MHz test circuit see page 6.

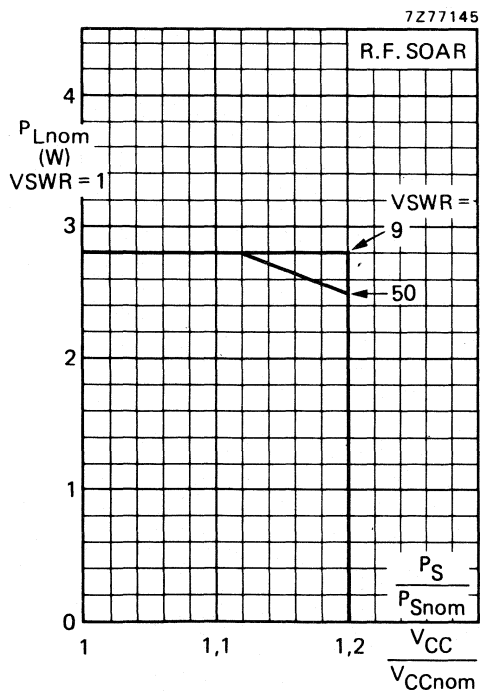
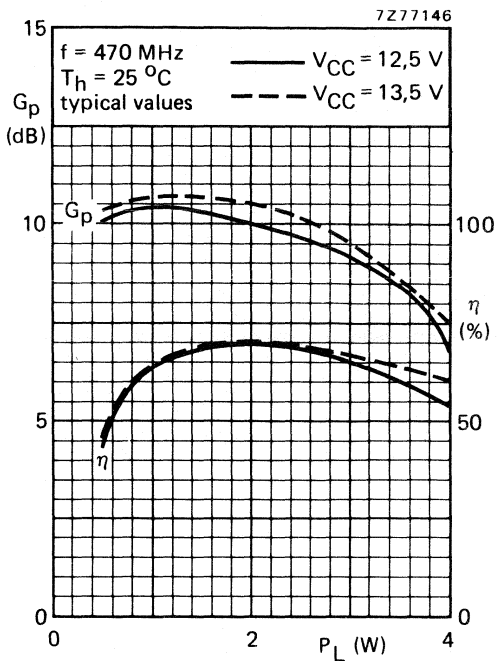
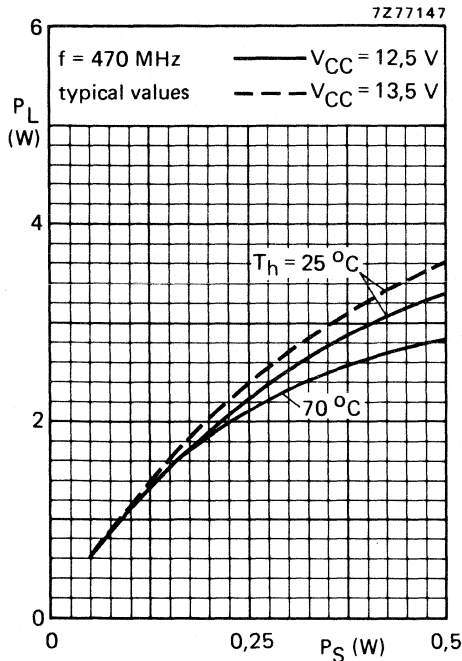
## APPLICATION INFORMATION (continued)

Component layout and printed-circuit board for 470 MHz test circuit.



The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.





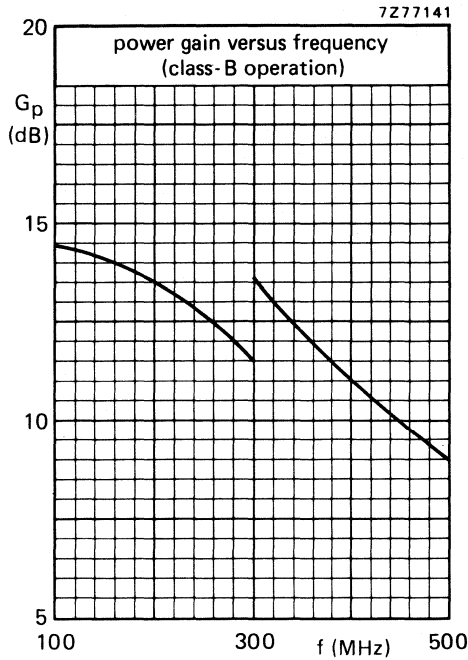
**Conditions for R.F. SOAR**

$f = 470 \text{ MHz}$   
 $T_h = 70 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} = 0,6 \text{ K/W}$   
 $V_{CCnom} = 12,5 \text{ V or } 13,5 \text{ V}$   
 $P_S = P_{Snom}$  at  $V_{CCnom}$  and  $V_{SWR} = 1$   
 see page 5

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $V_{SWR} = 1$ ), as a function of the expected supply over-voltage ratio, with  $V_{SWR}$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 300 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.



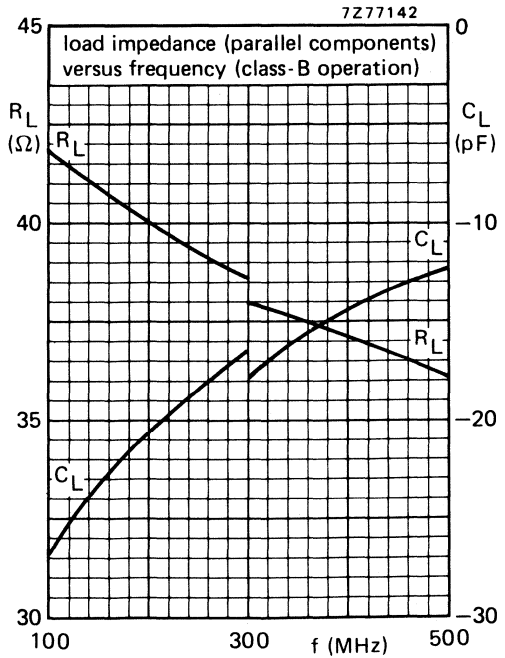
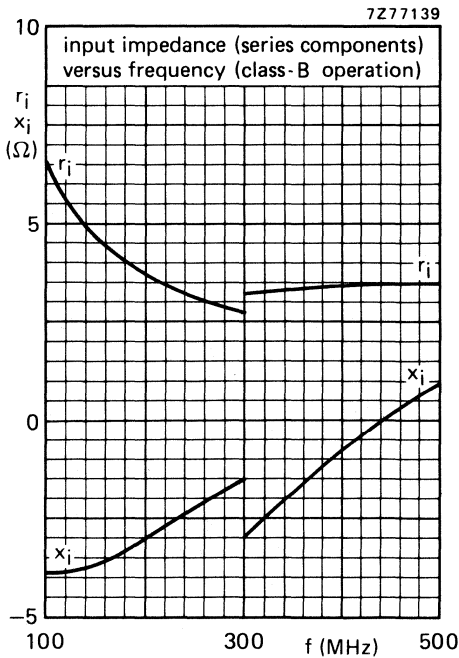
**Measuring conditions for the graphs on this page**

$V_{CC} = 12,5 \text{ V}$

$P_L = 2 \text{ W}$

$T_h = 25 \text{ }^\circ\text{C}$

typical values



U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for transmitting applications in class-A, B or C in the u.h.f. and v.h.f. range for nominal supply voltages up to 13,5 V.

The resistance stabilization of the transistor provides protection against device damage at severe load mismatch conditions.

The transistor is housed in a ¼" capstan envelope with a ceramic cap.

QUICK REFERENCE DATA

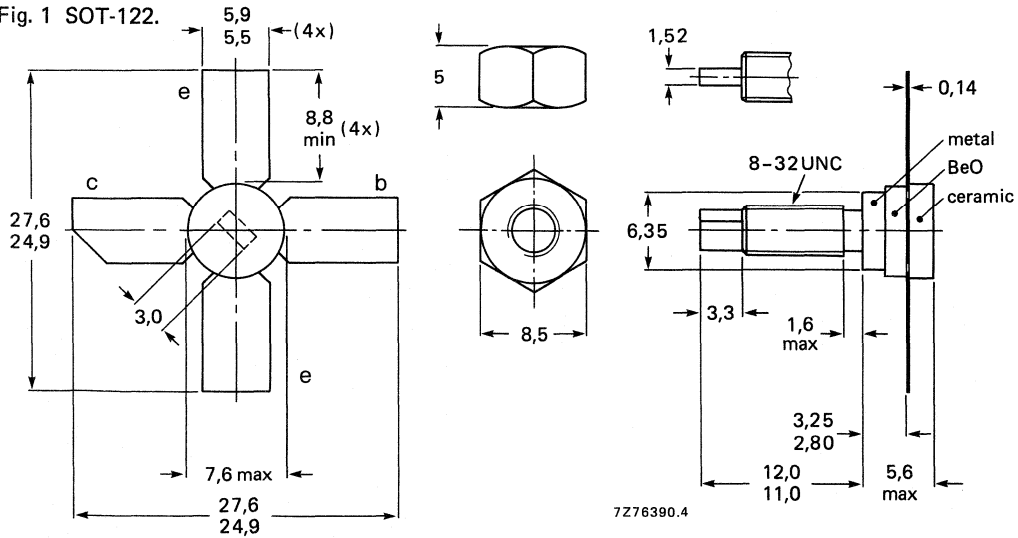
R.F. performance up to  $T_h = 25\text{ °C}$  in an unneutralized common-emitter class-B circuit

mode of operation	V <sub>CC</sub> V	f MHz	P <sub>L</sub> W	G <sub>p</sub> dB	η %	Z <sub>i</sub> Ω	Y <sub>L</sub> mS
c.w.	12,5	470	4	> 8,0	> 60	2,1 + j2,3	57 – j56
c.w.	12,5	175	4	typ. 15,0	typ. 60	2,0 – j2,2	51 – j48

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

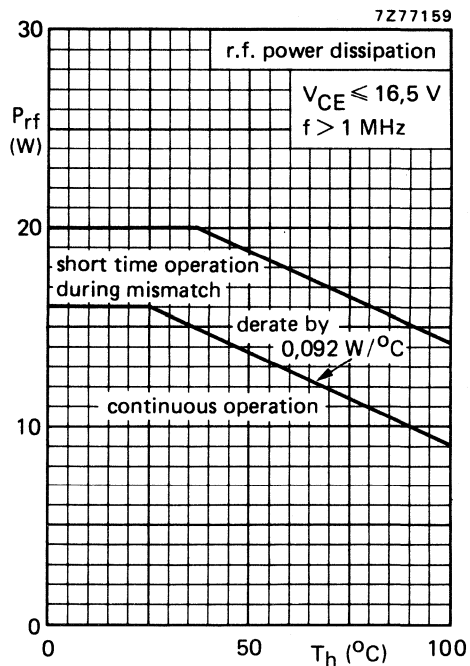
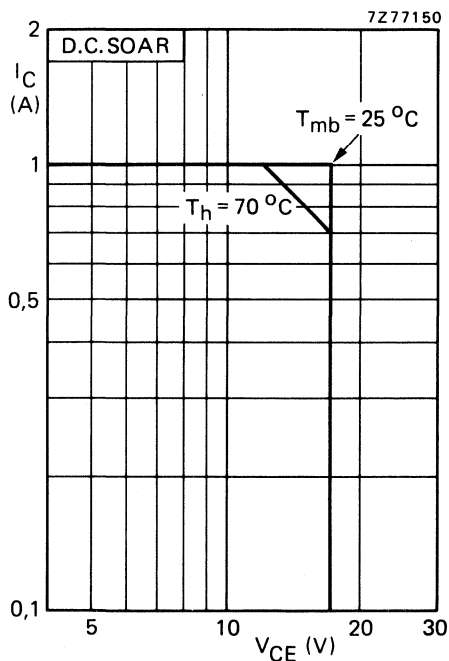
When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max	17 V
Emitter-base voltage (open collector)	$V_{EBO}$	max	4 V
Collector current (d.c.)	$I_C$	max	1 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max	3 A
Total power dissipation (d.c. and r.f.) up to $T_{mb} = 25$ °C	$P_{tot}$	max	17 W



Storage temperature	$T_{stg}$	-65 to +150 °C
Operating junction temperature	$T_j$	max 200 °C

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	10,3 °C/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,6 °C/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$ **Breakdown voltages**

Collector-emitter voltage

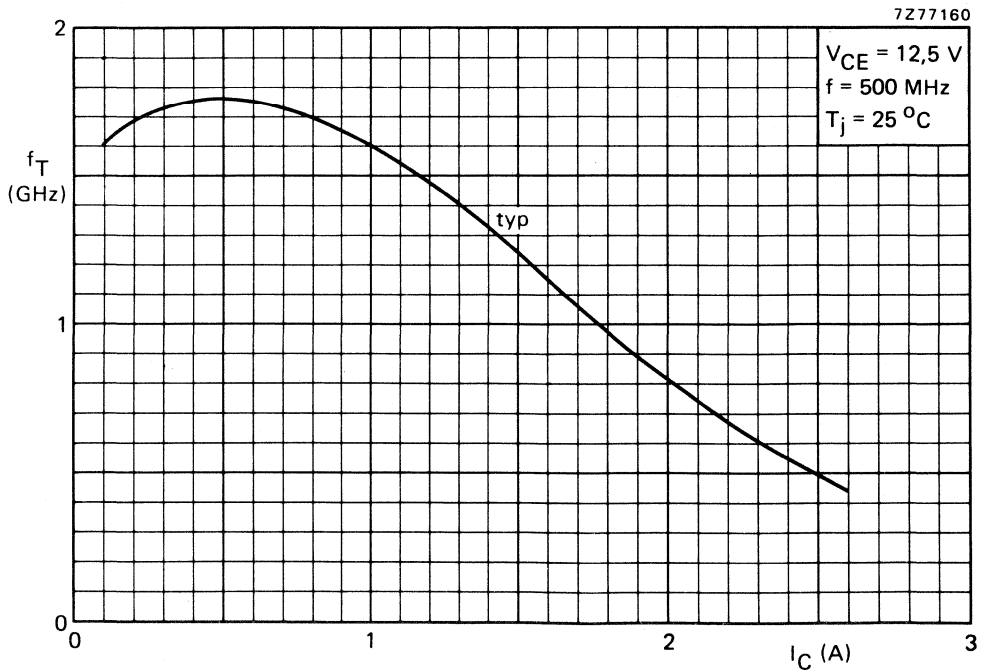
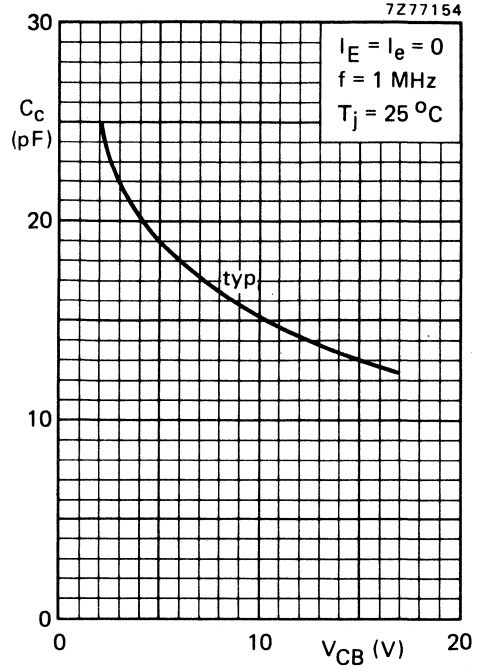
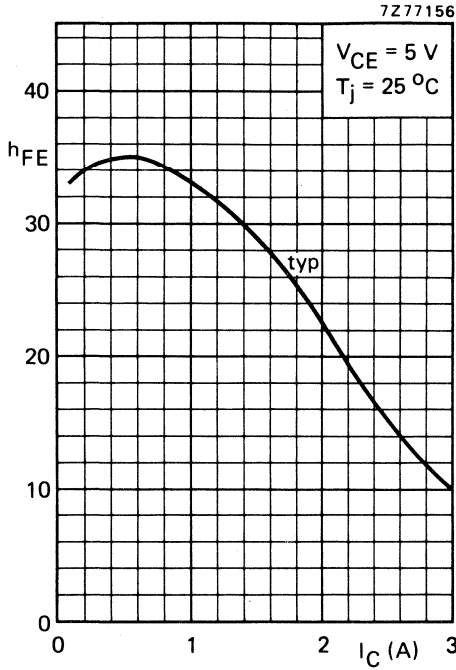
 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter voltage

open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 17\text{ V}$ 

Emitter-base voltage

open collector;  $I_E = 4\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ **Collector cut-off current** $V_{BE} = 0; V_{CE} = 17\text{ V}$  $I_{CES} < 4\text{ mA}$ **D.C. current gain \*** $I_C = 0,5\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE} > \text{typ } 10$   
 $35$ **Collector-emitter saturation voltage \*** $I_C = 1,5\text{ A}; I_B = 0,3\text{ A}$  $V_{CEsat} \text{ typ } 0,75\text{ V}$ **Transition frequency at  $f = 500\text{ MHz}$  \*** $I_C = 0,5\text{ A}; V_{CE} = 12,5\text{ V}$  $f_T \text{ typ } 1,75\text{ GHz}$  $I_C = 1,5\text{ A}; V_{CE} = 12,5\text{ V}$  $f_T \text{ typ } 1,25\text{ GHz}$ **Collector capacitance at  $f = 1\text{ MHz}$**  $I_E = I_e = 0; V_{CB} = 12,5\text{ V}$  $C_C \text{ typ } 14\text{ pF}$ **Feedback capacitance at  $f = 1\text{ MHz}$**  $I_C = 40\text{ mA}; V_{CE} = 12,5\text{ V}$  $C_{re} \text{ typ } 7,1\text{ pF}$ **Collector-stud capacitance** $C_{cs} \text{ typ } 1,2\text{ pF}$ \* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .



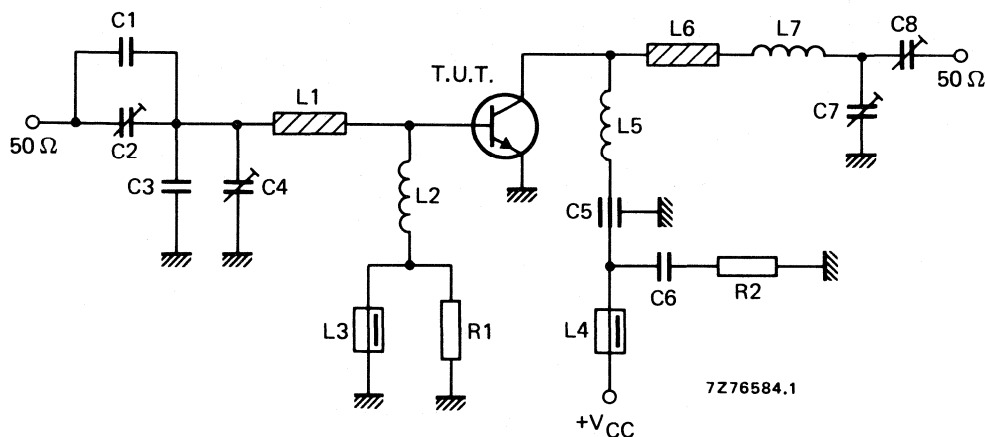
## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
470	12,5	4	< 0,63 >	8,0	< 0,53 >	60	2,1 + j2,3	57 - j56
470	13,5	4	—	typ 9,5	—	typ 65	—	—
175	12,5	4	—	typ 15,0	—	typ 60	2,0 - j2,2	51 - j48

Test circuit for 470 MHz



List of components:

C1 = 2,2 pF ( $\pm 0,25$  pF) ceramic capacitor

C2 = C7 = C8 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C3 = 5,6 pF ( $\pm 0,25$  pF) ceramic capacitor

C4 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C5 = 100 pF ceramic feed-through capacitor

C6 = 100 nF polyester capacitor

L1 = stripline (22,5 mm x 6,0 mm)

L2 = 13 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 4 mm; leads 2 x 5 mm

L3 = L4 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L5 = 51 nH; 3,5 turns Cu wire (1 mm); int. dia. 6 mm; coil length 7 mm; leads 2 x 5 mm

L6 = stripline (10,0 mm x 6,0 mm)

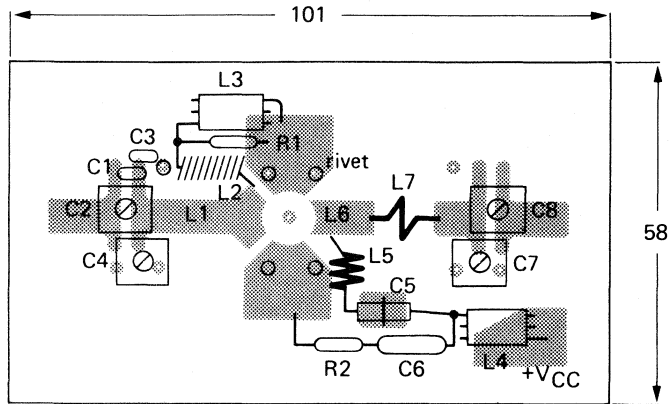
L7 = 15 nH; 1 turn Cu wire (1 mm); int. dia. 5 mm; leads 2 x 5 mm

L1 and L6 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16".R1 = R2 = 10  $\Omega$  ( $\pm 5\%$ ) carbon resistor

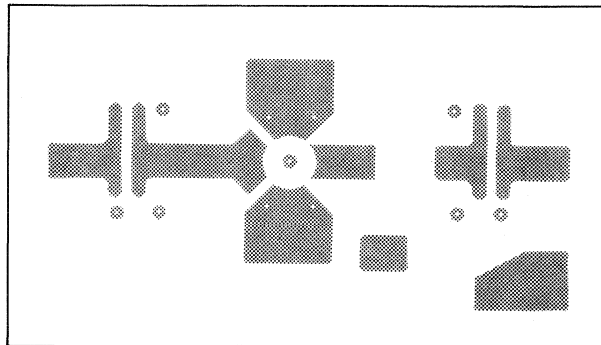
Component layout and printed-circuit board for 470 MHz test circuit see page 6.

**APPLICATION INFORMATION** (continued)

Component layout and printed-circuit board for 470 MHz test circuit.



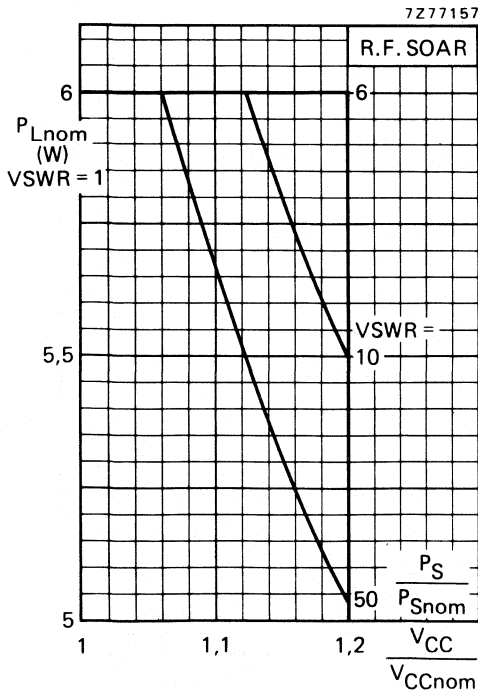
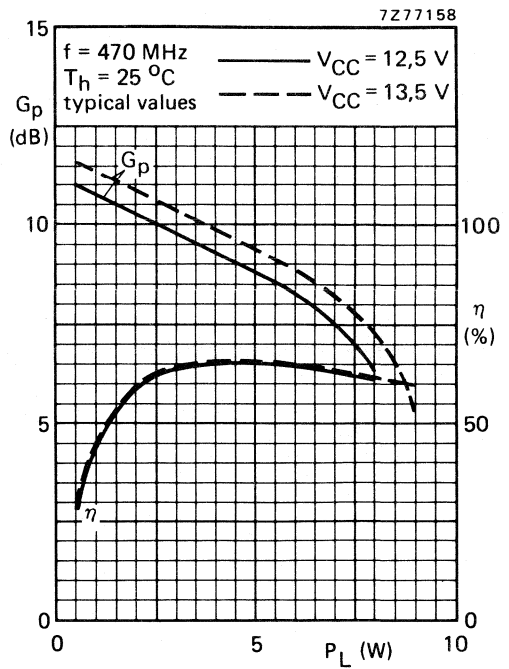
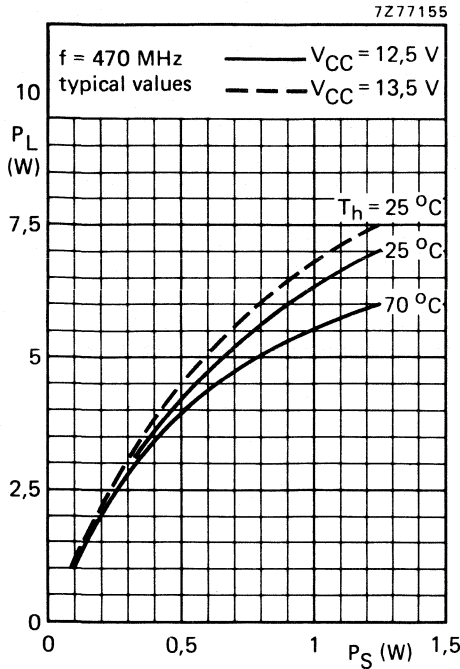
7Z76582



7Z76583

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.





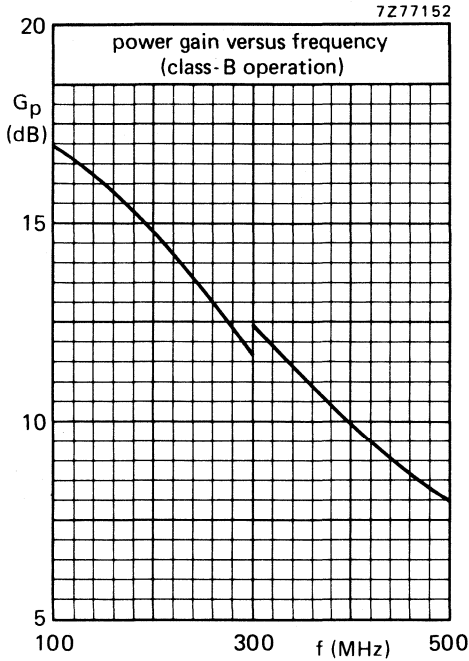
**Conditions for R.F. SOAR**

$f = 470 \text{ MHz}$   
 $T_h = 70^\circ\text{C}$   
 $R_{th \text{ mb-h}} = 0,6 \text{ K/W}$   
 $V_{CCnom} = 12,5 \text{ V or } 13,5 \text{ V}$   
 $P_S = P_{Snom}$  at  $V_{CCnom}$  and  $V_{SWR} = 1$   
 see page 5

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $V_{SWR} = 1$ ), as a function of the expected supply over-voltage ratio, with  $V_{SWR}$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 300 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.



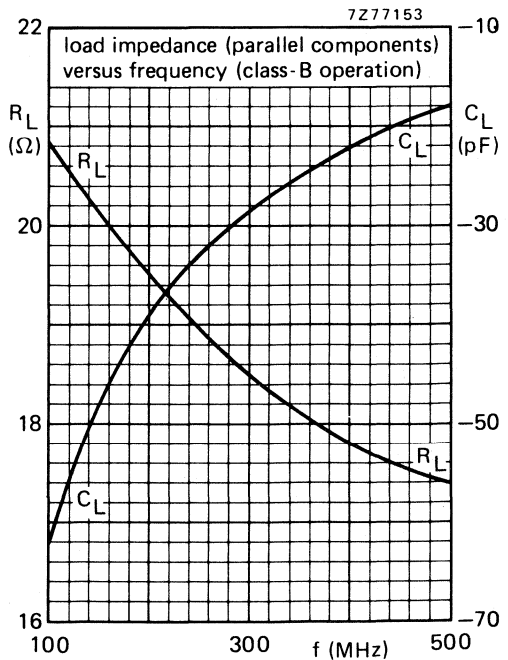
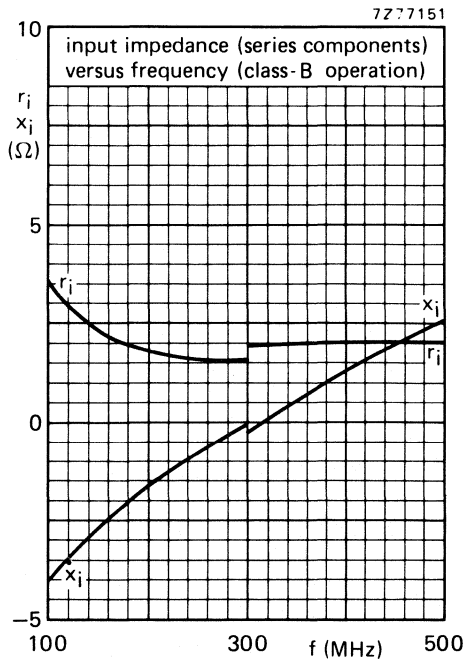
**Measuring conditions for the graphs on this page**

$V_{CC} = 12,5\ V$

$P_L = 4\ W$

$T_h = 25\ ^\circ C$

typical values



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for transmitting applications in class-A, B or C in the u.h.f. and v.h.f. range for nominal supply voltages up to 13,5 V.

The resistance stabilization of the transistor provides protection against device damage at severe load mismatch conditions.

The transistor is housed in a ¼" capstan envelope with a ceramic cap.

### QUICK REFERENCE DATA

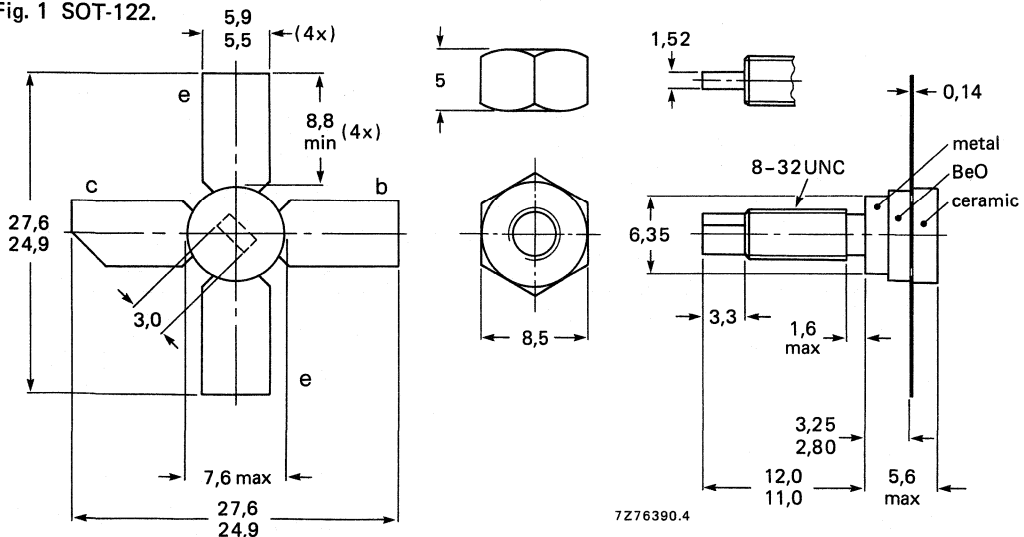
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CC}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	12,5	470	10	> 6,0	> 60	$1,3 + j2,5$	$150 - j66$
c.w.	12,5	175	10	typ. 13,5	typ. 60	$1,2 - j0,6$	$140 - j80$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

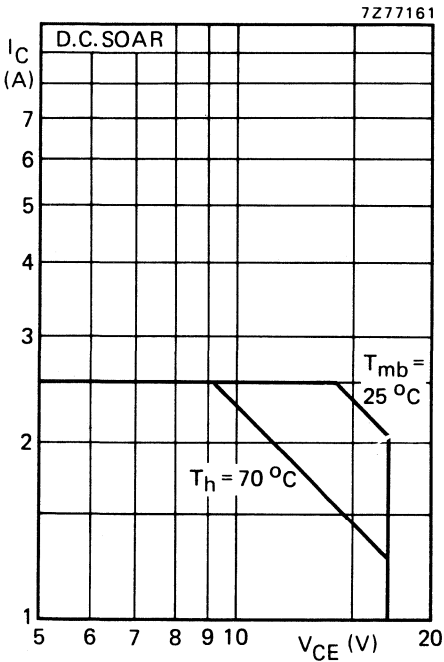
When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max	17 V
Emitter-base voltage (open collector)	$V_{EBO}$	max	4 V
Collector current (d.c. or average)	$I_C$	max	2,5 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max	7,5 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{tot}$	max	40 W



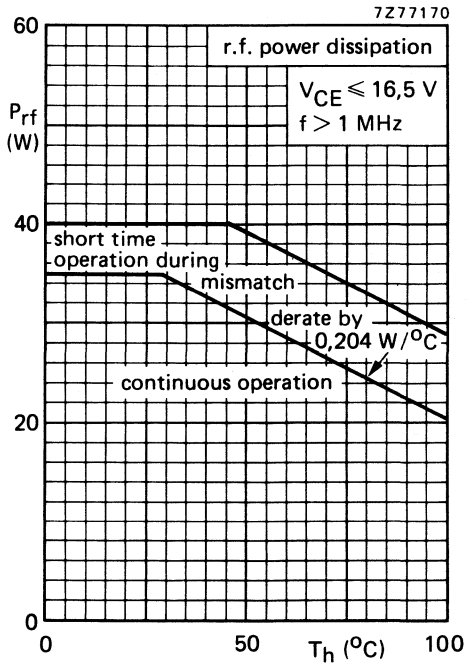
Storage temperature  
Operating junction temperature

**THERMAL RESISTANCE**

From junction to mounting base  
From mounting base to heatsink

$T_{stg}$	=	-65 to +150 °C
$T_j$	max	200 °C

$R_{th\ j-mb}$	=	4,3 K/W
$R_{th\ mb-h}$	=	0,6 K/W



**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$ **Breakdown voltages**

Collector-emitter voltage

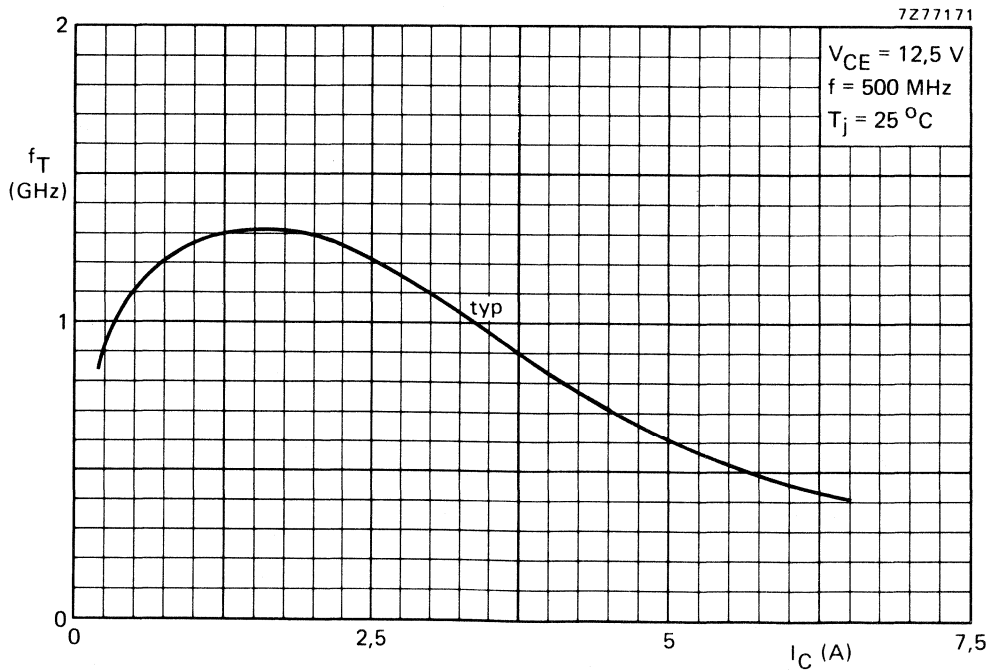
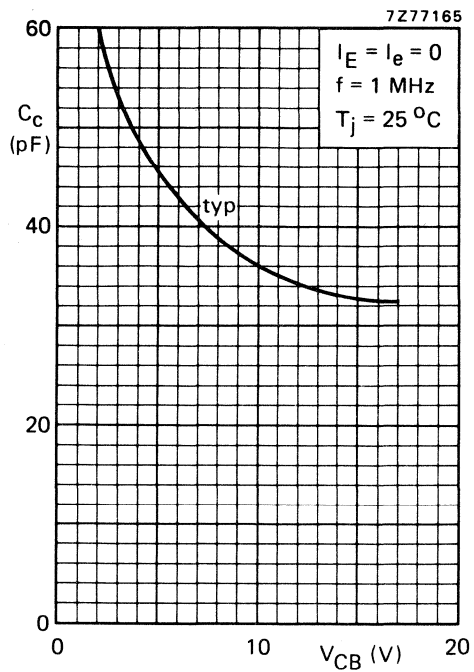
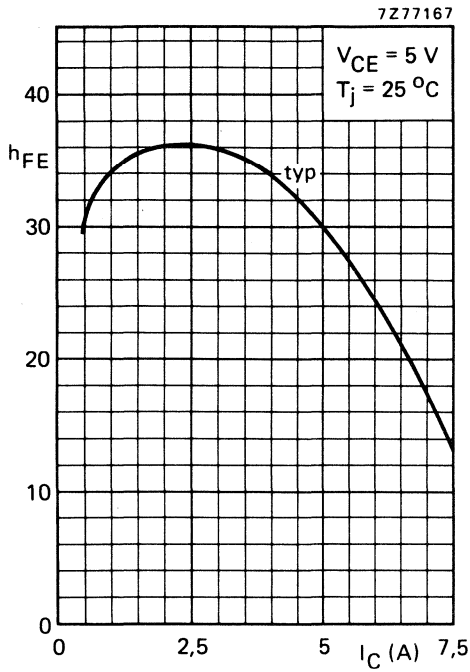
 $V_{BE} = 0; I_C = 25\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter voltage

open base;  $I_C = 100\text{ mA}$  $V_{(BR)CEO} > 17\text{ V}$ 

Emitter-base voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ **Collector cut-off current** $V_{BE} = 0; V_{CE} = 17\text{ V}$  $I_{CES} < 10\text{ mA}$ **D.C. current gain \*** $I_C = 1,25\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE} > \begin{matrix} 10 \\ \text{typ} \\ 35 \end{matrix}$ **Collector-emitter saturation voltage \*** $I_C = 3,75\text{ A}; I_B = 0,75\text{ A}$  $V_{CEsat} \text{ typ } 0,75\text{ V}$ **Transition frequency at  $f = 500\text{ MHz}$  \*** $I_C = 1,25\text{ A}; V_{CE} = 12,5\text{ V}$  $f_T \text{ typ } 1,3\text{ GHz}$  $I_C = 3,75\text{ A}; V_{CE} = 12,5\text{ V}$  $f_T \text{ typ } 0,9\text{ GHz}$ **Collector capacitance at  $f = 1\text{ MHz}$**  $I_E = I_e = 0; V_{CB} = 12,5\text{ V}$  $C_C \text{ typ } 34\text{ pF}$ **Feedback capacitance at  $f = 1\text{ MHz}$**  $I_C = 100\text{ mA}; V_{CE} = 12,5\text{ V}$  $C_{re} \text{ typ } 18\text{ pF}$ **Collector-stud capacitance** $C_{cs} \text{ typ } 1,2\text{ pF}$ \* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .



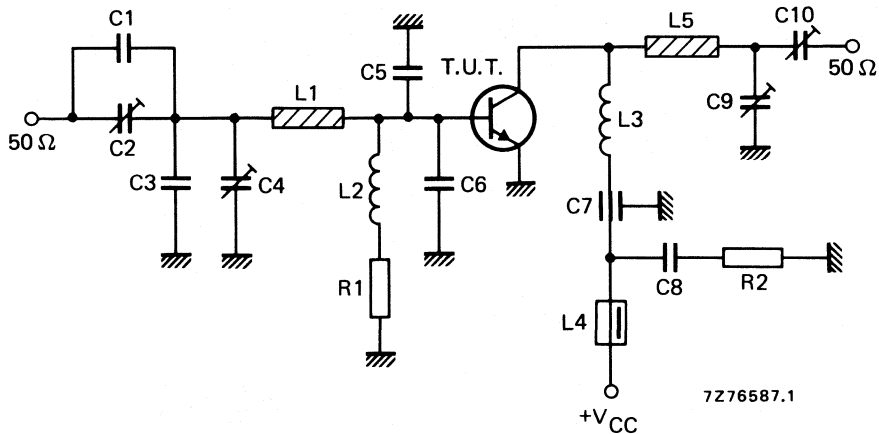
## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
470	12,5	10	< 2,5 > 6,0		< 1,33 > 60		$1,3 + j2,5$	$150 - j66$
470	13,5	10	typ 1,9	typ 7,2	—	typ 75	—	—
175	12,5	10	typ 0,45	typ 13,5	—	typ 60	$1,2 - j0,6$	$140 - j80$

Test circuit for 470 MHz



List of components:

C1 = 2,2 pF ( $\pm 0,25$  pF) ceramic capacitor

C2 = C9 = C10 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)

C3 = 3,9 pF ( $\pm 0,25$  pF) ceramic capacitor

C4 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C5 = C6 = 15 pF ceramic chip capacitor (cat. no. 2222 851 13159)

C7 = 100 pF ceramic feed-through capacitor

C8 = 100 nF polyester capacitor

L1 = stripline (27,9 mm x 6,0 mm)

L2 = 13 turns closely wound enamelled Cu wire (0,5 mm); int. dia. = 4 mm; leads 2 x 5 mm

L3 = 17 nH; 1½ turns enamelled Cu wire (1 mm); spacing 1 mm; int. dia. = 6 mm; leads 2 x 5 mm

L4 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

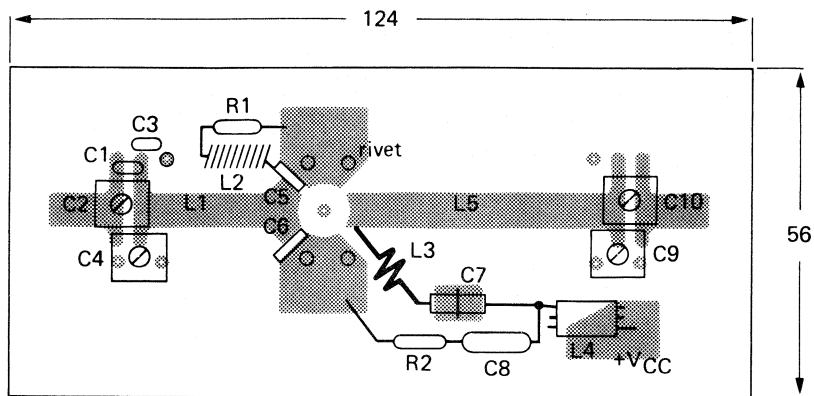
L5 = stripline (45,8 mm x 6,0 mm)

L1 and L5 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16".R1 = 1  $\Omega$  ( $\pm 5\%$ ) carbon resistorR2 = 10  $\Omega$  ( $\pm 5\%$ ) carbon resistor

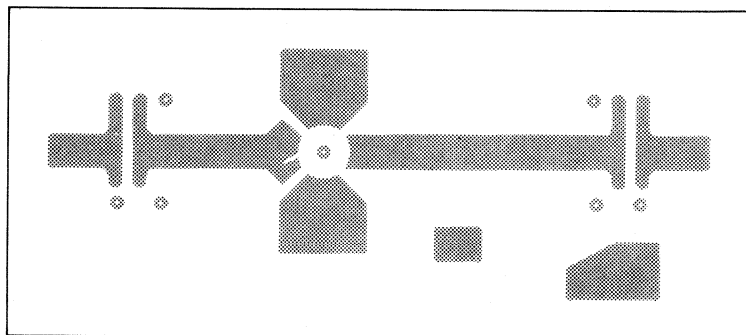
Component layout and printed-circuit board for 470 MHz test circuit see page 6.

**APPLICATION INFORMATION** (continued)

Component layout and printed-circuit board for 470 MHz test circuit.



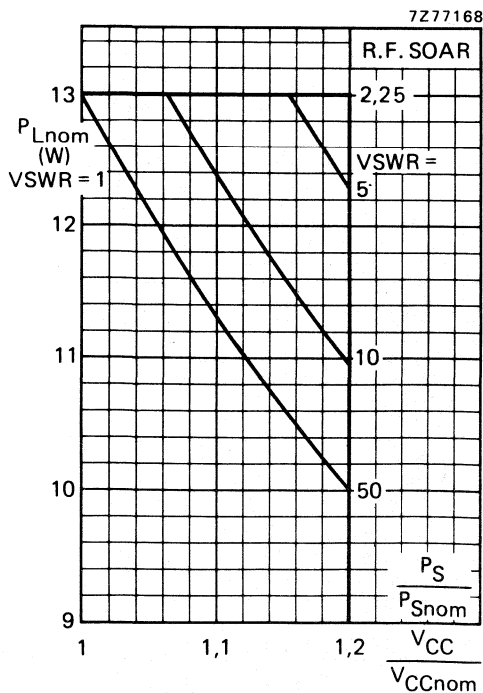
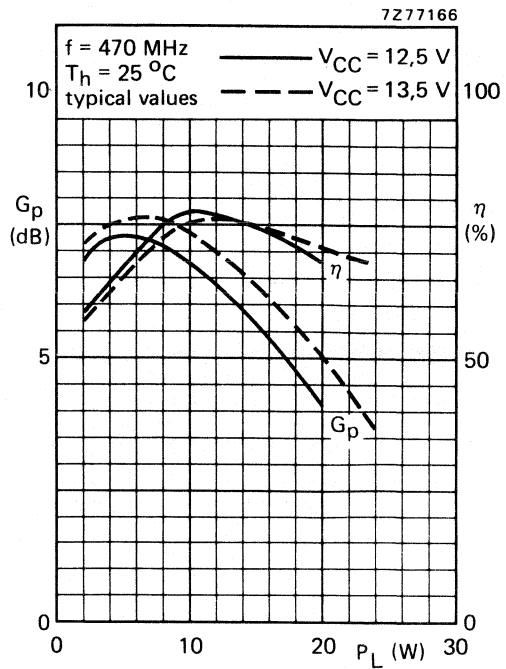
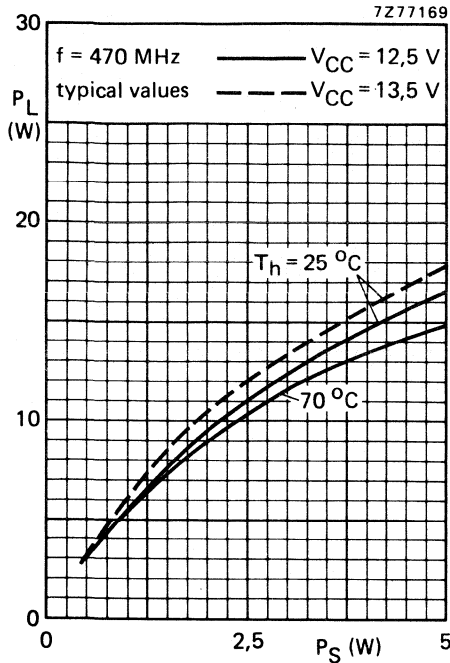
7276585



7276586

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.





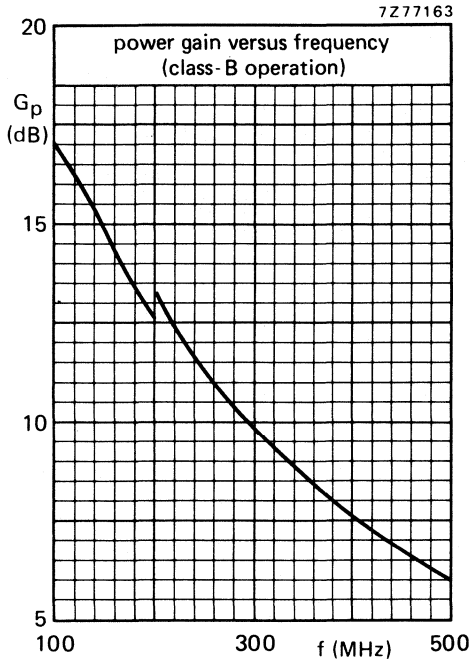
**Measuring conditions for R.F. SOAR**

$f = 470 \text{ MHz}$   
 $T_h = 70 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} = 0,6 \text{ K/W}$   
 $V_{CCnom} = 12,5 \text{ V or } 13,5 \text{ V}$   
 $P_S = P_{Snom}$  at  $V_{CCnom}$  and  $V_{SWR} = 1$   
 see page 5

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $V_{SWR} = 1$ ), as a function of the expected supply over-voltage ratio, with  $V_{SWR}$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 200 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.



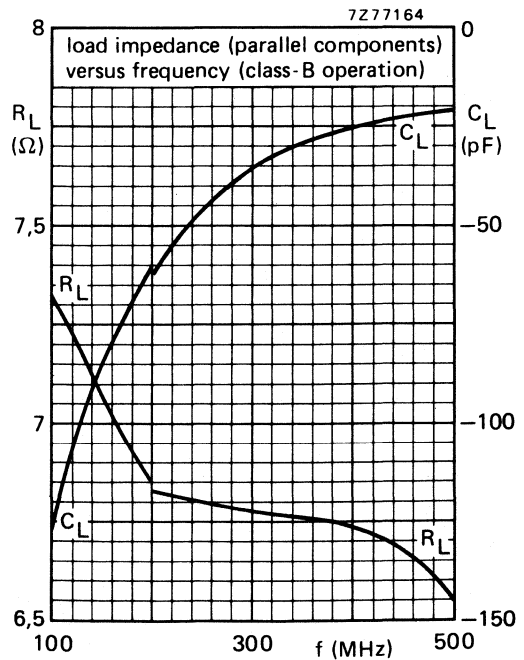
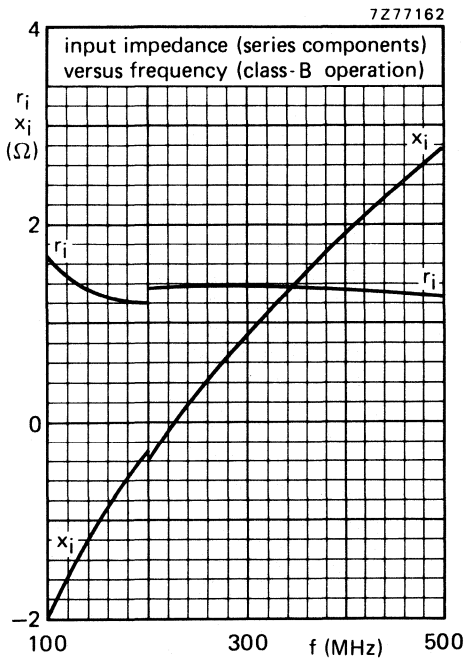
**Measuring conditions for the graphs on this page**

$V_{CC} = 12,5\text{ V}$

$P_L = 10\text{ W}$

$T_h = 25\text{ }^\circ\text{C}$

typical values



## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in transmitting amplifiers operating in the h.f. and v.h.f. bands, with a nominal supply voltage of 28 V. The transistor is specified for s.s.b. applications as linear amplifier in class-A and AB. The device is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

Matched  $h_{FE}$  groups are available on request.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

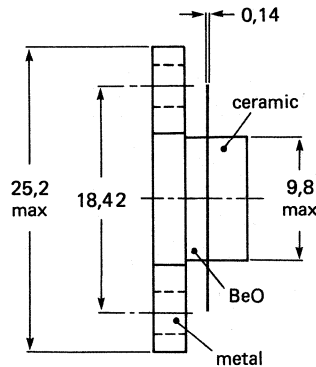
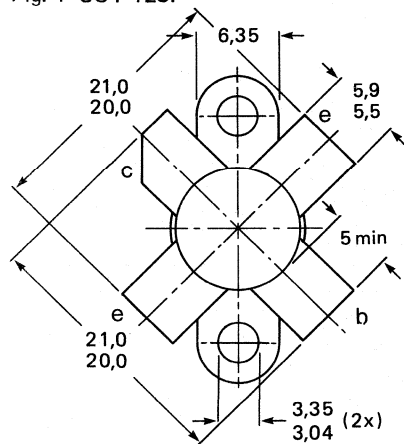
R.F. performance

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_{dt}$ %	$I_C$ A	$d_3$ dB	$T_h$ °C
s.s.b. (class-A)	26	1,6 - 28	0 - 10 (P.E.P.)	> 20	—	1,35	< -40	70
s.s.b. (class-AB)	28	1,6 - 28	3 - 30 (P.E.P.)	typ. 21	typ. 40	typ. 1,34	typ. -30	25

### MECHANICAL DATA

Dimensions in mm

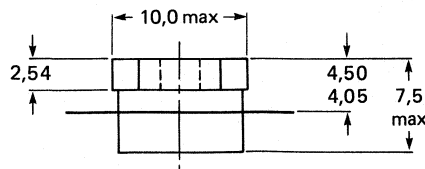
Fig. 1 SOT-123.



Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open-collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	3 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	9 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	76 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

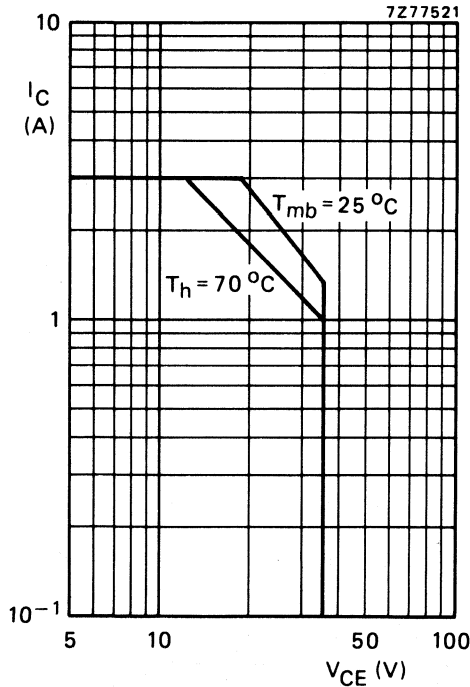


Fig. 2 D.C. SOAR.

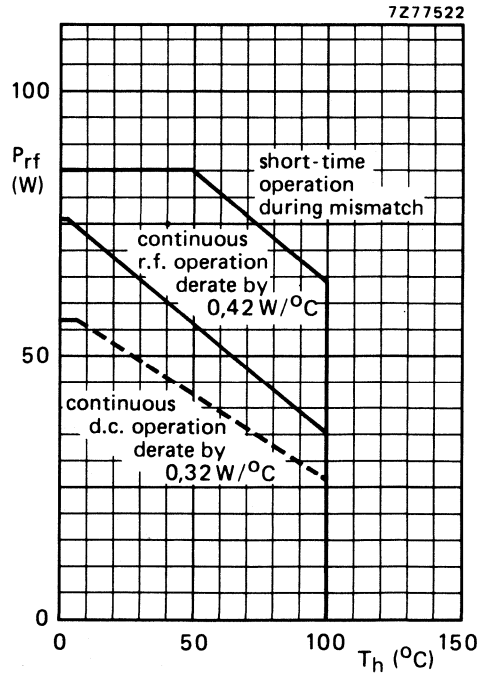


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f \geq 1$  MHz.

**THERMAL RESISTANCE** (dissipation = 35 W;  $T_{mb} = 80$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	3,15 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	2,35 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,3 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage  
 $V_{BE} = 0; I_C = 10\text{ mA}$

$V_{(BR)CES} > 65\text{ V}$

Collector-emitter breakdown voltage  
 open base;  $I_C = 50\text{ mA}$

$V_{(BR)CEO} > 36\text{ V}$

Emitter-base breakdown voltage  
 open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current  
 $V_{BE} = 0; V_{CE} = 36\text{ V}$

$I_{CES} < 4\text{ mA}$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$   
 open base  
 $R_{BE} = 10\text{ }\Omega$

$E_{SBO} > 8\text{ mJ}$   
 $E_{SBR} > 8\text{ mJ}$

D.C. current gain\*  
 $I_C = 1,25\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE}$  typ. 50  
 10 to 100

D.C. current gain ratio of matched devices\*  
 $I_C = 1,25\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE1}/h_{FE2} < 1,2$

Collector-emitter saturation voltage\*  
 $I_C = 3,75\text{ A}; I_B = 0,75\text{ A}$

$V_{CEsat}$  typ. 1,5 V

Transition frequency at  $f = 100\text{ MHz}$ \*  
 $-I_E = 1,25\text{ A}; V_{CB} = 28\text{ V}$   
 $-I_E = 3,75\text{ A}; V_{CB} = 28\text{ V}$

$f_T$  typ. 530 MHz  
 $f_T$  typ. 530 MHz

Collector capacitance at  $f = 1\text{ MHz}$   
 $I_E = I_e = 0; V_{CB} = 28\text{ V}$

$C_c$  typ. 50 pF

Feedback capacitance at  $f = 1\text{ MHz}$   
 $I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$

$C_{re}$  typ. 31 pF

Collector-flange capacitance

$C_{cf}$  typ. 2 pF

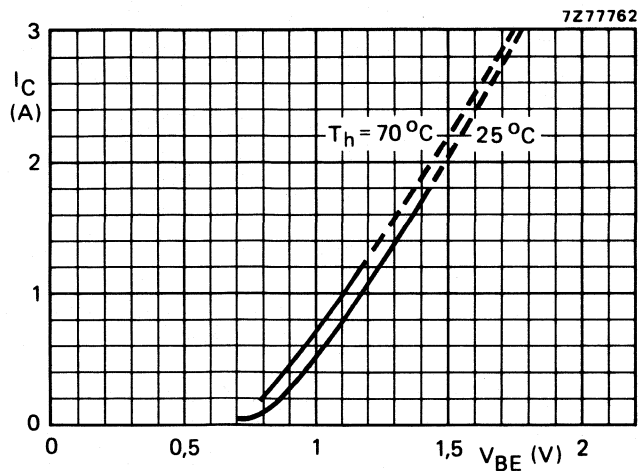


Fig. 4 Typical values;  $V_{CE} = 28\text{ V}$ .

\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

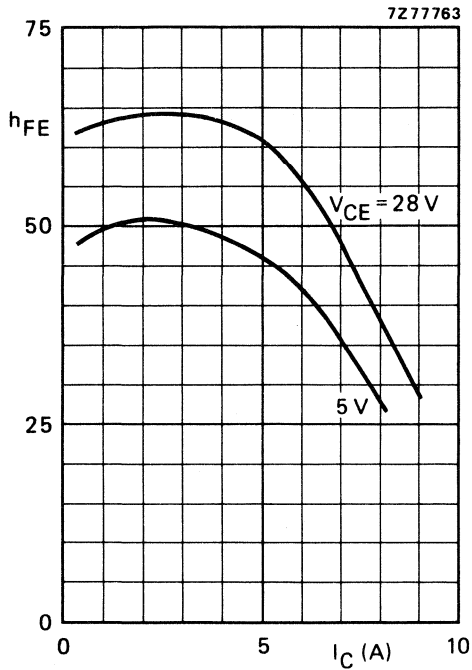


Fig. 5 Typical values;  $T_j = 25^\circ\text{C}$ .

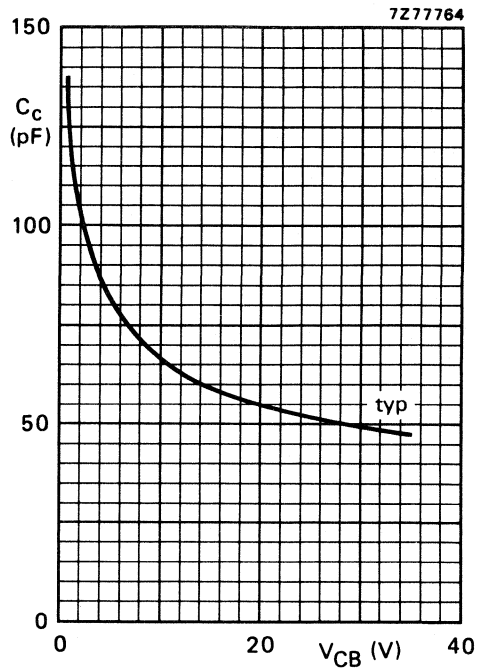


Fig. 6  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25^\circ\text{C}$ .

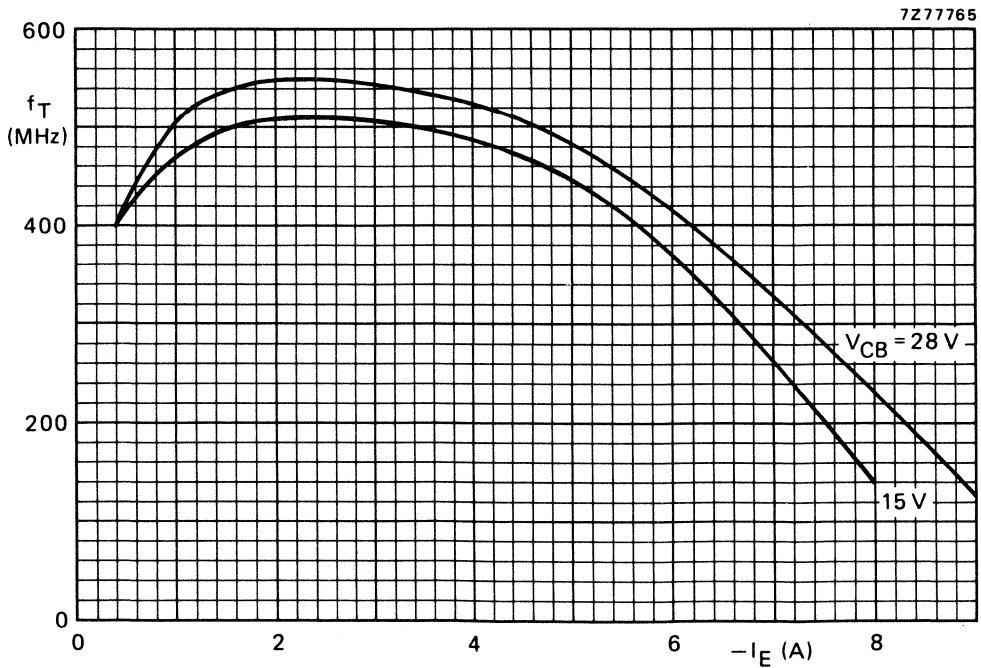


Fig. 7 Typical values;  $f = 100$  MHz;  $T_j = 25^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in s.s.b. class-A operation (linear power amplifier)

 $V_{CE} = 26 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$I_C$ A	$d_3$ dB*	$d_5$ dB*	$T_h$ °C
> 10 (P.E.P.) typ. 11 (P.E.P.)	> 20	1,35	-40	< -40	70
typ. 12 (P.E.P.)	typ. 24	1,35	-40	< -40	25

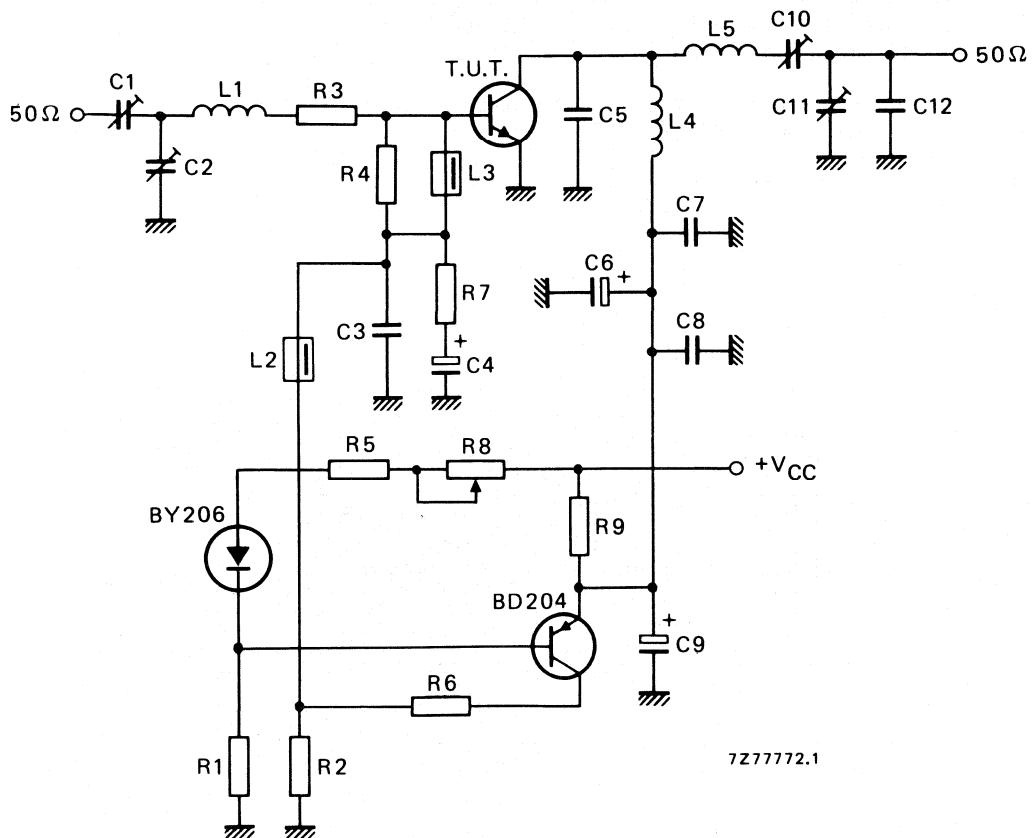


Fig. 8 Test circuit; s.s.b. class-A.

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

List of components in Fig. 8:

- C1 = C2 = 10 to 780 pF film dielectric trimmer  
 C3 = 22 nF ceramic capacitor (63 V)  
 C4 = 47  $\mu$ F/10 V electrolytic capacitor  
 C5 = 56 pF ceramic capacitor (500 V)  
 C6 = 47  $\mu$ F/35 V electrolytic capacitor  
 C7 = C8 = 220 nF polyester capacitor  
 C9 = 10  $\mu$ F/35 V electrolytic capacitor  
 C10 = C11 = 7 to 100 pF film dielectric trimmer  
 C12 = 82 pF ceramic capacitor (500 V)

- L1 = 3 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 9,0 mm; leads to 2 x 5 mm  
 L2 = L3 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)  
 L4 = 11 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 11,0 mm  
 L5 = 14 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 11,0 mm

- R1 = 600  $\Omega$ ; parallel connection of 2 x 1,2 k $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,5 W each)  
 R2 = 15  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,25 W)  
 R3 = 1,2  $\Omega$ ; parallel connection of 4 x 4,7  $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,125 W each)  
 R4 = 33  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,25 W)  
 R5 = 18  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,25 W)  
 R6 = 120  $\Omega$  wirewound resistor ( $\pm 5\%$ ; 5,5 W)  
 R7 = 1  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,125 W)  
 R8 = 47  $\Omega$  wirewound potentiometer (3 W)  
 R9 = 1,57  $\Omega$ ; parallel connection of 3 x 4,7  $\Omega$  wirewound resistors ( $\pm 5\%$ ; 5,5 W each)

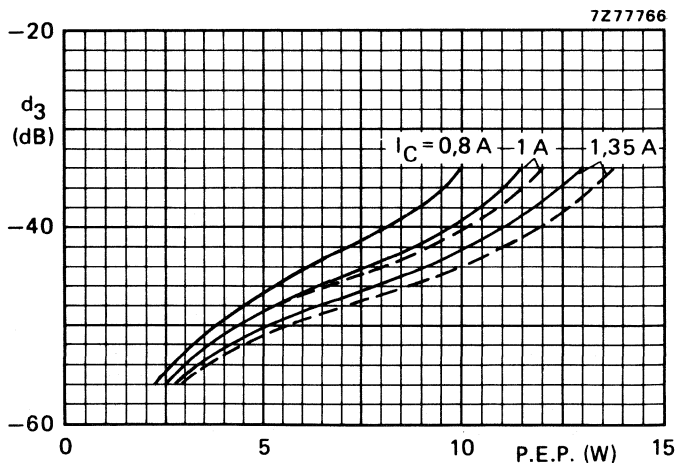


Fig. 9 Intermodulation distortion as a function of output power. Typical values;  $V_{CE} = 26\text{ V}$ ; —  $T_h = 70^\circ\text{C}$ ; ---  $T_h = 25^\circ\text{C}$ .



R.F. performance in s.s.b. class-AB operation (linear power amplifier)

$V_{CE} = 28 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$\eta_{dt}$ (%) at 30 W P.E.P.	$I_C$ (A)	$d_3$ dB*	$d_5$ dB*	$I_{C(ZS)}$ mA	$T_h$ °C
3 to 30 (P.E.P.)	typ. 21	typ. 40	typ. 1,34	typ. -30	< -30	25	25
3 to 25 (P.E.P.)	typ. 21	—	—	typ. -30	< -30	25	70

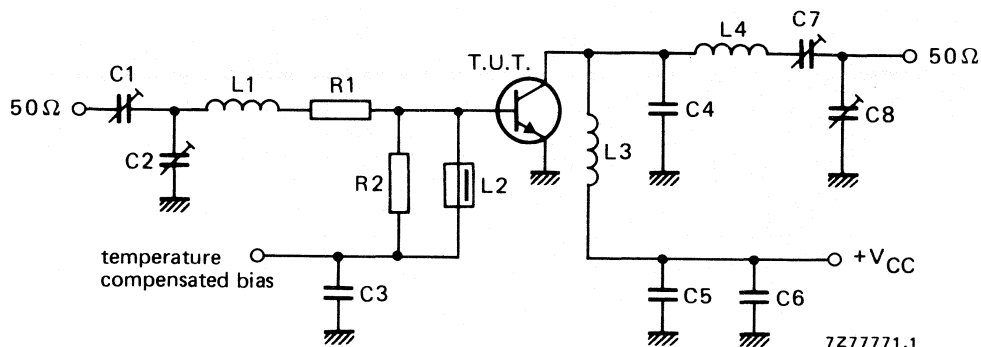


Fig. 10 Test circuit; s.s.b. class-AB.

List of components:

C1 = C2 = 10 to 780 pF film dielectric trimmer

C3 = C5 = C6 = 220 nF polyester capacitor

C4 = 56 pF ceramic capacitor (500 V)

C7 = C8 = 15 to 575 pF film dielectric trimmer

L1 = 4 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 7,0 mm; leads 2 x 5 mm

L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 4 turns enamelled Cu wire (1,6 mm); int. dia. 10 mm; length 9,4 mm; leads 2 x 5 mm

L4 = 7 turns enamelled Cu wire (1,6 mm); int. dia. 12 mm; length 17,2 mm; leads 2 x 5 mm

R1 = 1,2  $\Omega$ ; parallel connection of 4 x 4,7  $\Omega$  carbon resistors

R2 = 39  $\Omega$  carbon resistor

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

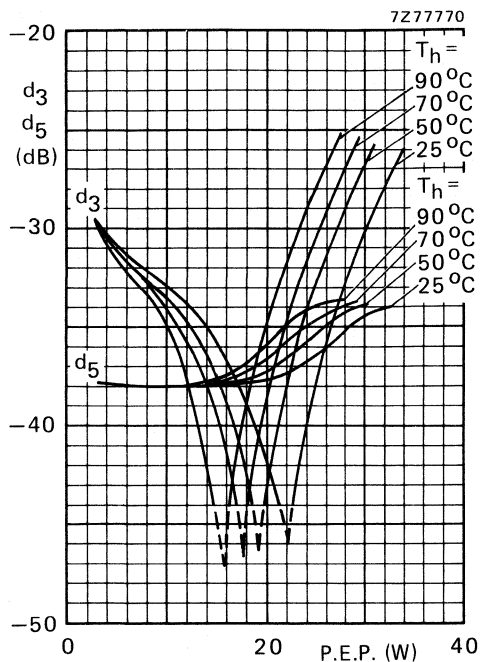


Fig. 11 Intermodulation distortion as a function of output power.\*

Conditions for Fig. 11:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 25 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ; typical values.

Conditions for Fig. 12:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 25 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 25^\circ\text{C}$ ; typical values.

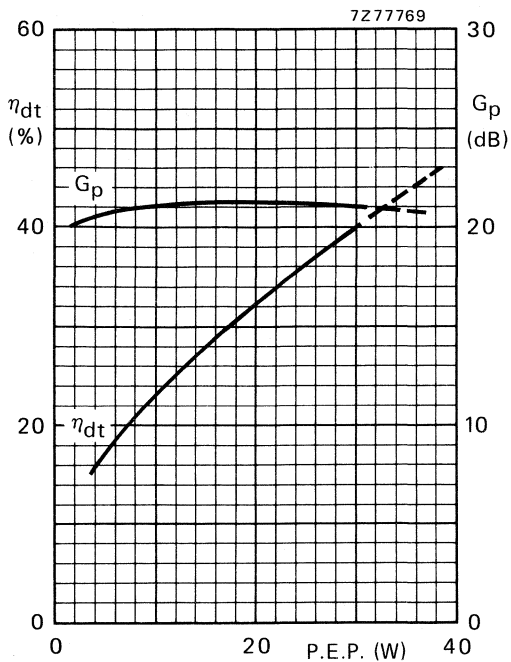


Fig. 12 Double-tone efficiency and power gain as a function of output power.

\* See note on previous page.

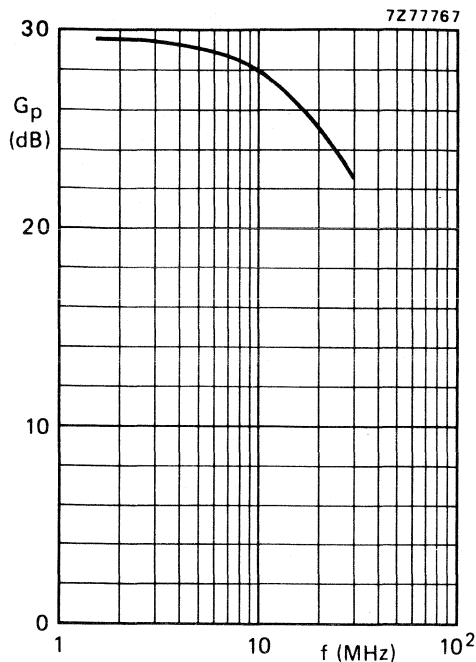


Fig. 13 Power gain as a function of frequency.

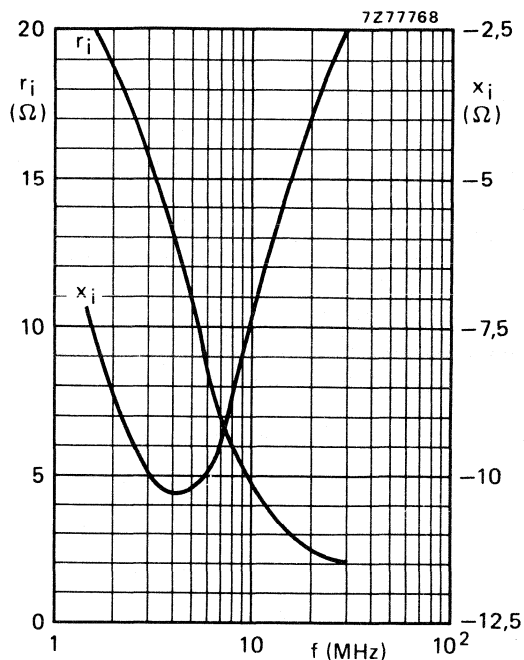


Fig. 14 Input impedance (series components) as a function of frequency.

Figs 13 and 14 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 25 \text{ mA}$ ;  $P_L = 30 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 9,5 \text{ } \Omega$ .

#### Ruggedness in s.s.b. operation

The BLW83 is capable of withstanding a load mismatch ( $V_{SWR} = 50$ ) under the following conditions:  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $V_{CE} = 28 \text{ V}$ ;  $T_h = 70 \text{ }^\circ\text{C}$  and  $P_{Lnom} = 35 \text{ W (P.E.P.)}$ .



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated v.h.f. transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

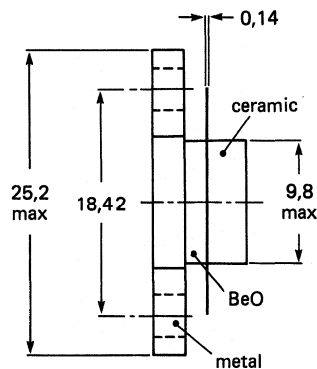
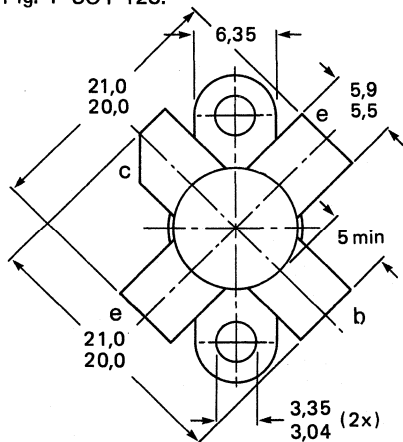
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	25	> 9	> 60	$1,0 + j1,2$	$59 - j54$

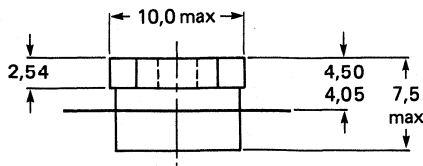
### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.



7Z77386.2



Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	3 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	9 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	76 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

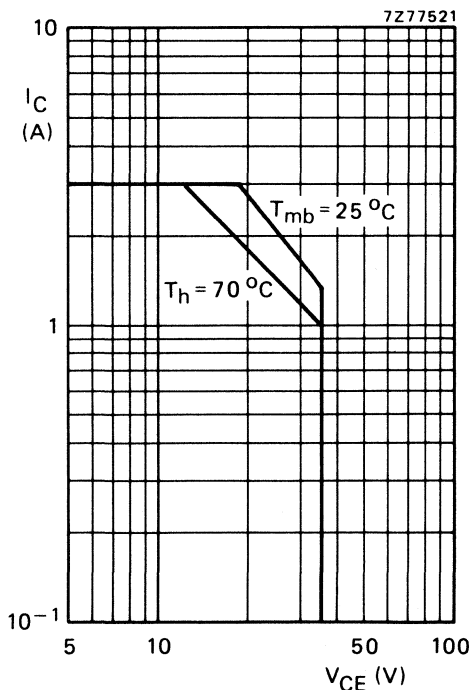


Fig. 2 D.C. SOAR.

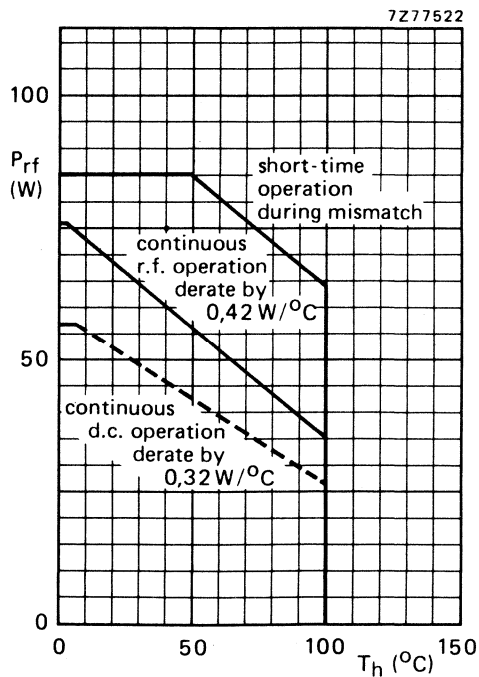


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f \geq 1$  MHz.

**THERMAL RESISTANCE** (dissipation = 20 W;  $T_{mb} = 76$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb\ (dc)}$	=	3,0 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb\ (rf)}$	=	2,25 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,3 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 36\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 36\text{ V}$  $I_{CES} < 4\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\text{ }\Omega$  $E_{SBO} > 8\text{ mJ}$  $E_{SBR} > 8\text{ mJ}$ 

D.C. current gain \*

 $I_C = 1,25\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 45  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 3,75\text{ A}; I_B = 0,75\text{ A}$  $V_{CEsat}$  typ. 1,5 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 1,25\text{ A}; V_{CB} = 28\text{ V}$  $-I_E = 3,75\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 650 MHz $f_T$  typ. 650 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_C$  typ. 45 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re}$  typ. 28 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

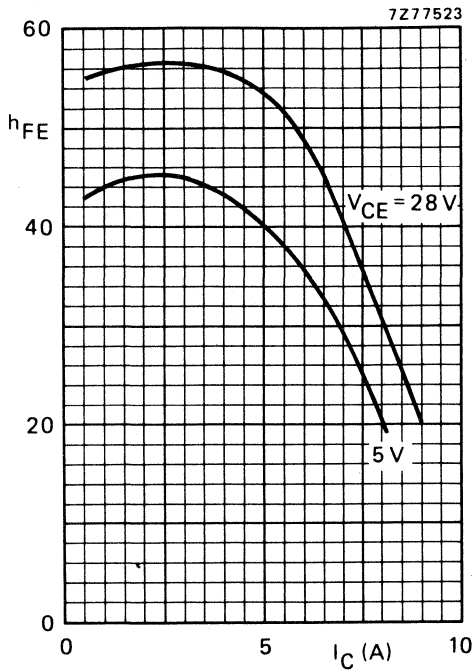


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

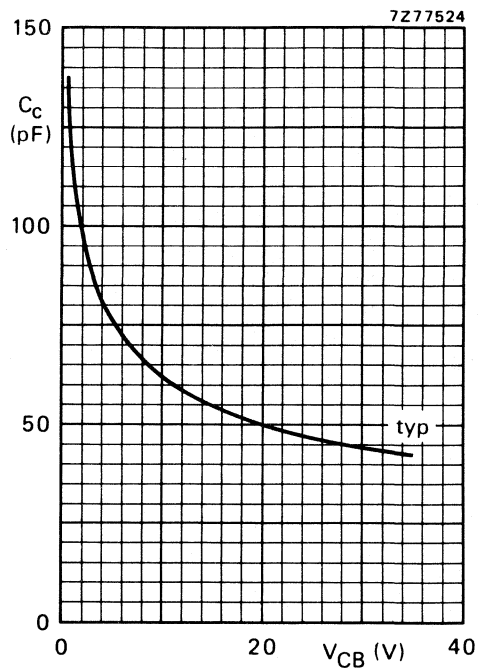


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

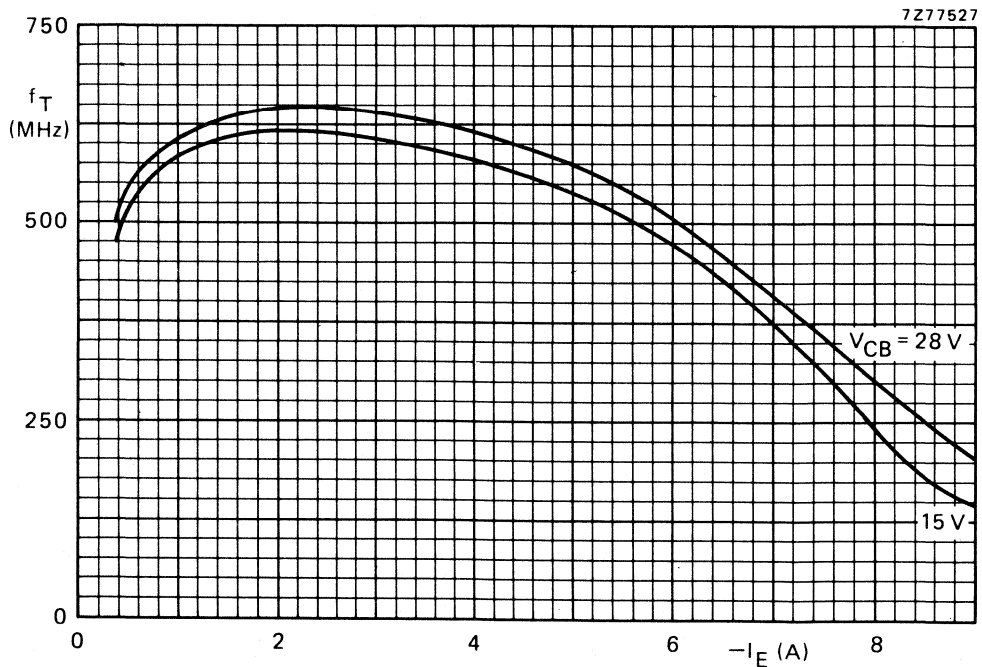


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .



## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	28	25	< 3,15	> 9	< 1,49	> 60	$1,0 + j1,2$	$59 - j54$

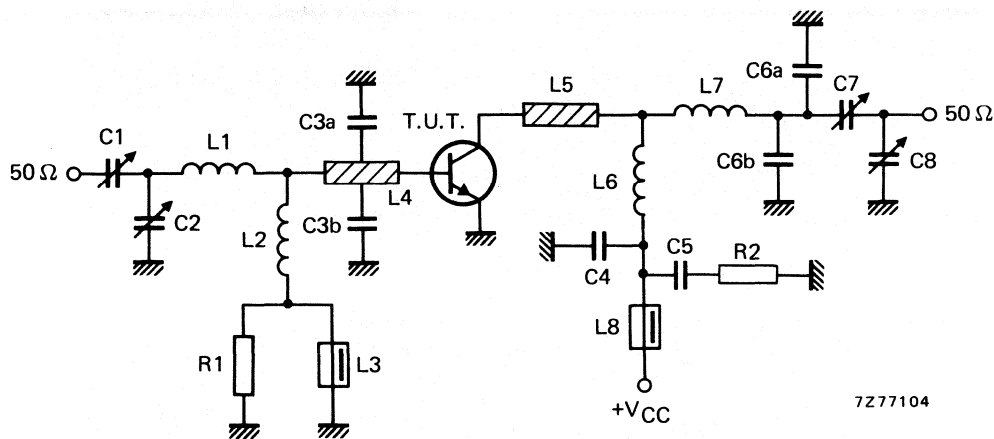


Fig. 7 Test circuit; c.w. class-B.

## List of components

C1 = C7 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF ( $\pm 10\%$ ) polyester capacitor

C6a = 2,2 pF ceramic capacitor (500 V)

C6b = 1,8 pF ceramic capacitor (500 V)

C8 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

L1 = 14 nH; 1 turn enamelled Cu wire (1,6 mm); int. dia. 7,7 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L6 = 80 nH; 3 turns enamelled Cu wire (1,6 mm); int. dia. 9,0 mm; length 8,0 mm; leads 2 x 5 mm

L7 = 62 nH; 3 turns enamelled Cu wire (1,6 mm); int. dia. 7,5 mm; length 8,1 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  ( $\pm 10\%$ ) carbon resistor (0,25 W)

Component layout and printed-circuit board for 175 MHz test circuit are shown in Fig. 8.

## APPLICATION INFORMATION (continued)

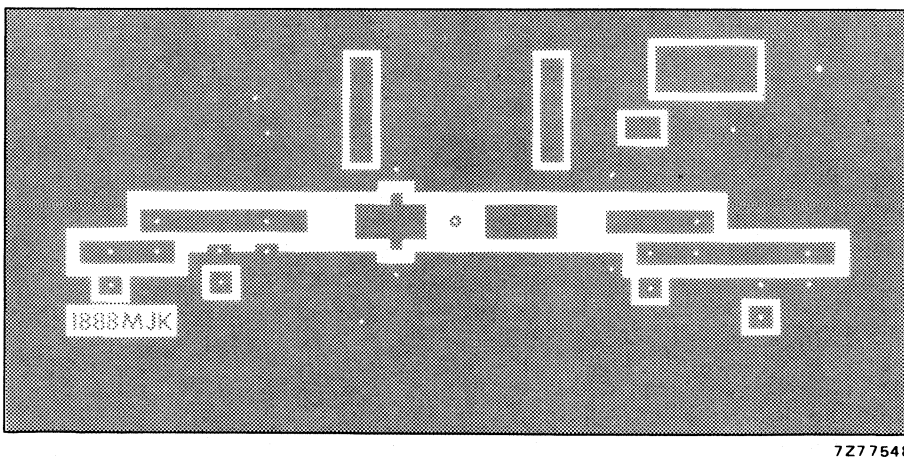
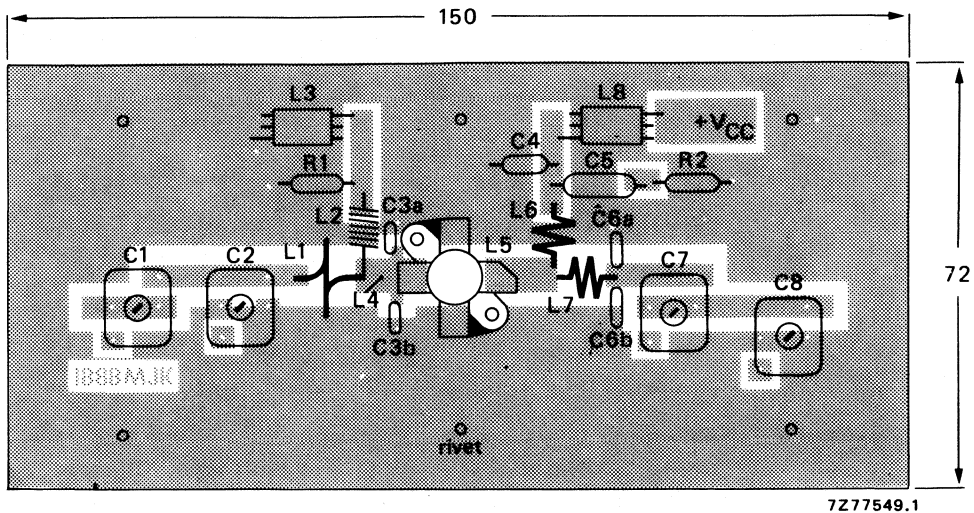


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

To minimize the dielectric losses, the ground plane under the interconnection of L7 and C7 has been removed.

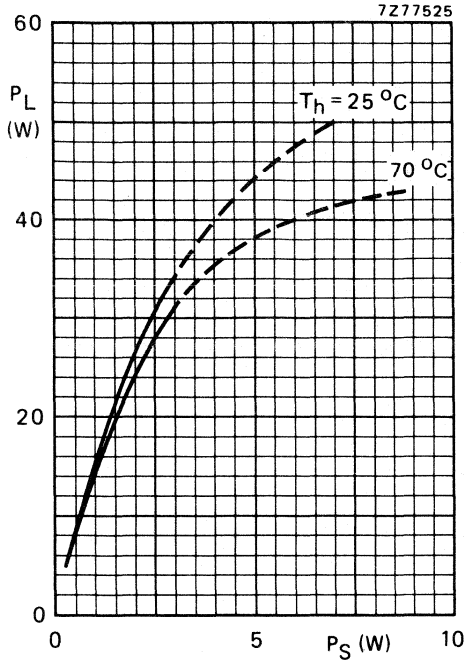


Fig. 9  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ ; typical values.

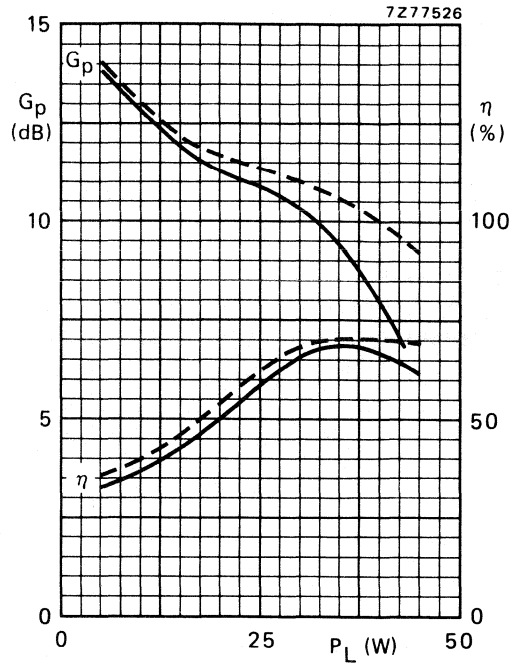


Fig. 10  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ ; typical values; ---  $T_h = 25^\circ\text{C}$ ; —  $T_h = 70^\circ\text{C}$ .

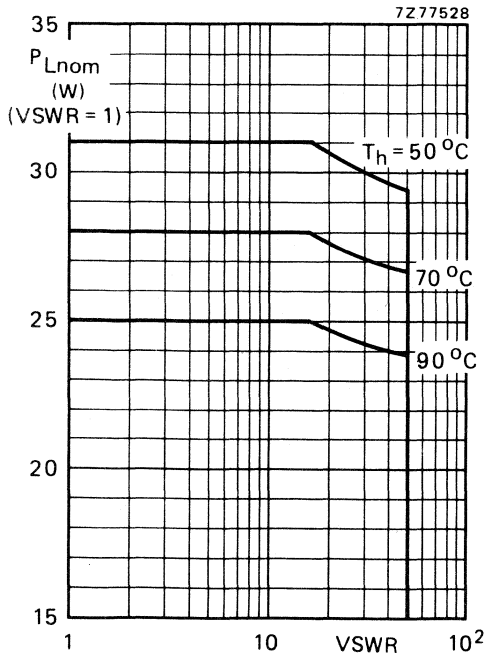


Fig. 11 R.F. SOAR; c.w. class-B operation;  $f = 175\text{ MHz}$ ;  $V_{CE} = 28\text{ V}$ ;  $R_{th\text{ mb-h}} = 0,3\text{ K/W}$   
The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

**OPERATING NOTE** Below 70 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

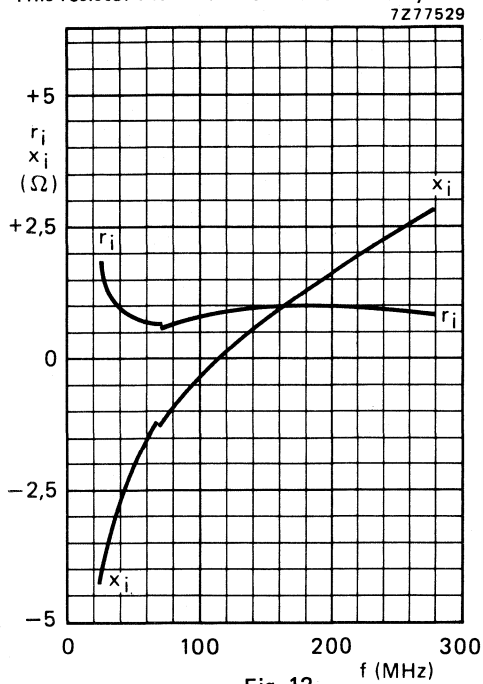


Fig. 12.

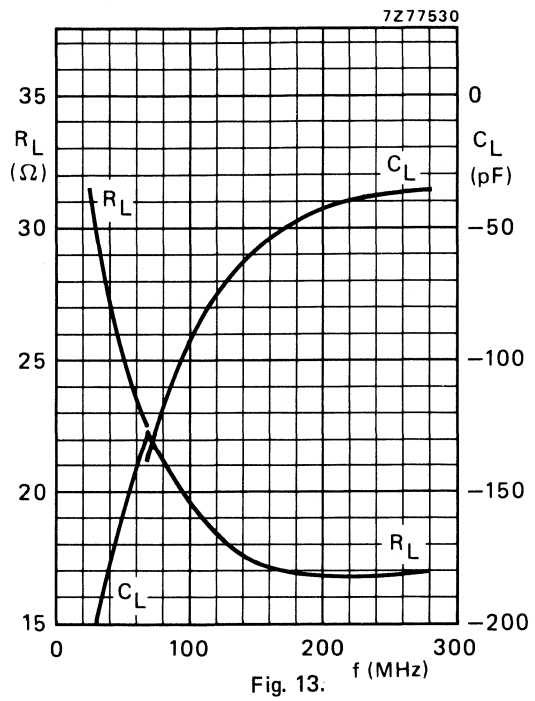
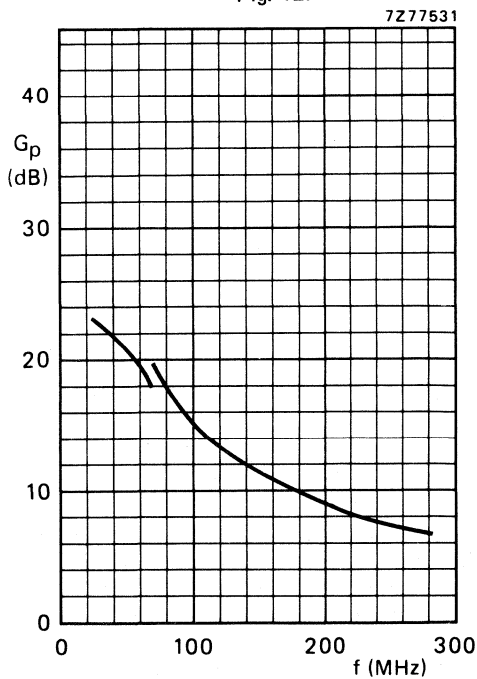


Fig. 13.



Conditions for Figs 12, 13 and 14:  
 Typical values;  $V_{CE} = 28$  V;  $P_L = 25$  W;  
 $T_h = 25$   $^{\circ}$ C.

Fig. 14.

## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile h.f. and v.h.f. transmitters with a nominal supply voltage of 12,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V. Matched  $h_{FE}$  groups are available on request.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

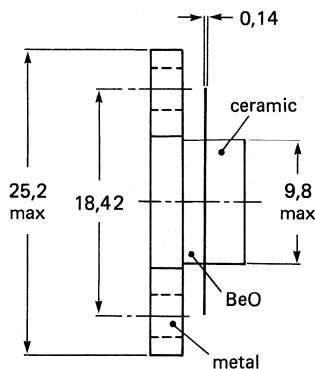
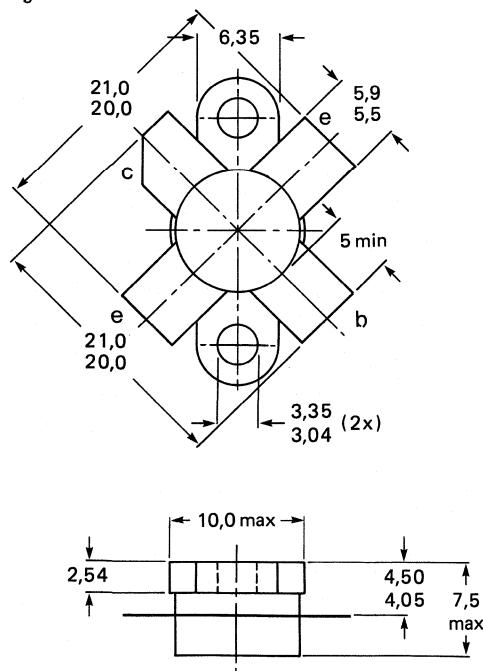
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{z}_L$ $\Omega$	$d_3$ dB
c.w. (class-B)	12,5	175	45	> 4,5	> 75	$1,4 + j1,5$	$2,7 - j1,3$	—
s.s.b. (class-AB)	12,5	1,6–28	3–30 (P.E.P.)	typ. 19,5	typ. 35	—	—	typ. -33

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.



7277386.2

Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18 V
Emitter-base voltage (open-collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	9 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	22 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	105 W
Storage temperature	$T_{stg}$		- 65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

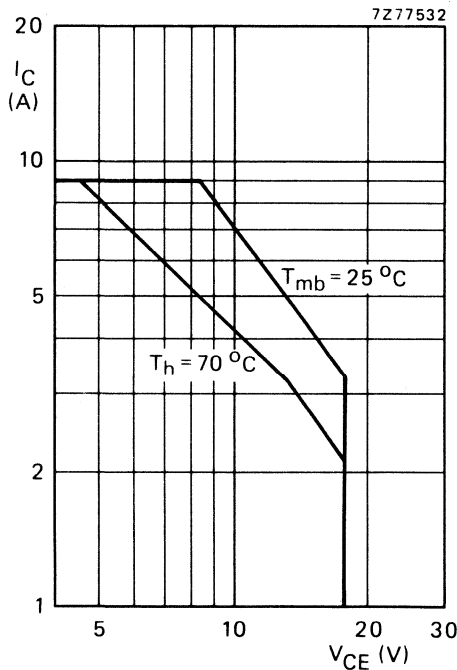


Fig. 2 D.C. SOAR.

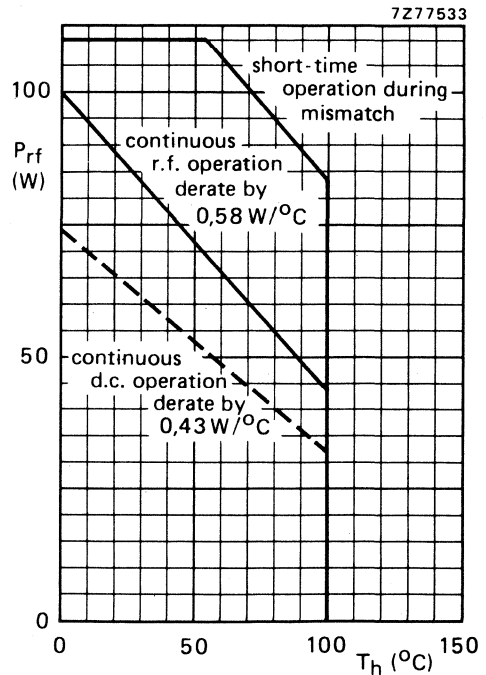


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f \geq 1$  MHz.

**THERMAL RESISTANCE** (dissipation = 30 W;  $T_{mb} = 79$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	2,5 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	1,8 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,3 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 50\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 100\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 25\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 25\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\text{ }\Omega$  $E_{SBO} > 8\text{ mJ}$  $E_{SBR} > 8\text{ mJ}$ 

D.C. current gain\*

 $I_C = 4\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 50  
10 to 80

D.C. current gain ratio of matched devices\*

 $I_C = 4\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE1}/h_{FE2} < 1,2$ 

Collector-emitter saturation voltage\*

 $I_C = 12,5\text{ A}; I_B = 2,5\text{ A}$  $V_{CEsat}$  typ. 1,5 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 4\text{ A}; V_{CB} = 12,5\text{ V}$  $-I_E = 12,5\text{ A}; V_{CB} = 12,5\text{ V}$  $f_T$  typ. 650 MHz $f_T$  typ. 600 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 15\text{ V}$  $C_c$  typ. 120 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 200\text{ mA}; V_{CE} = 15\text{ V}$  $C_{re}$  typ. 82 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

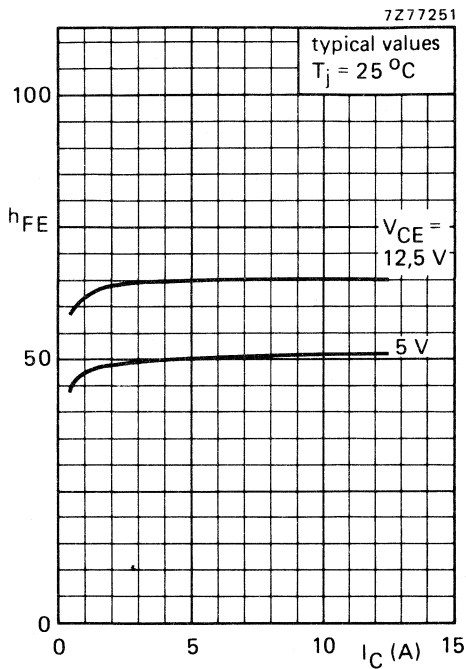


Fig. 4.

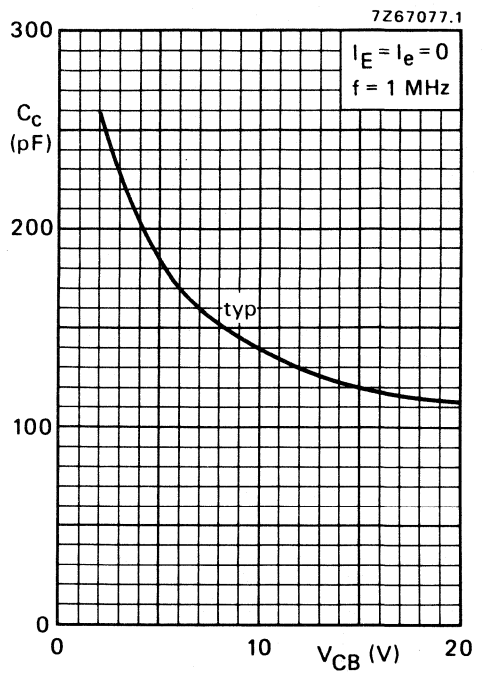


Fig. 5  $T_j = 25^\circ\text{C}$ .

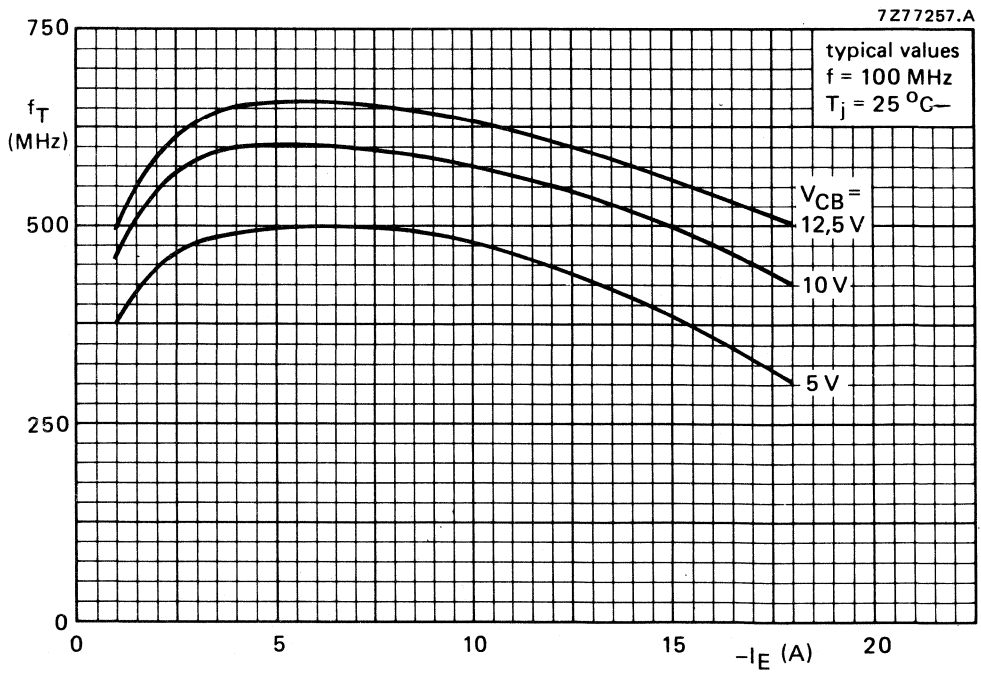


Fig. 6.



## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Z}_L$ ( $\Omega$ )
175	12,5	45	< 16	> 4,5	< 4,8	> 75	1,4 + j1,5	2,7 - j1,3
175	13,5	45	—	typ. 6,0	—	typ. 75	—	—

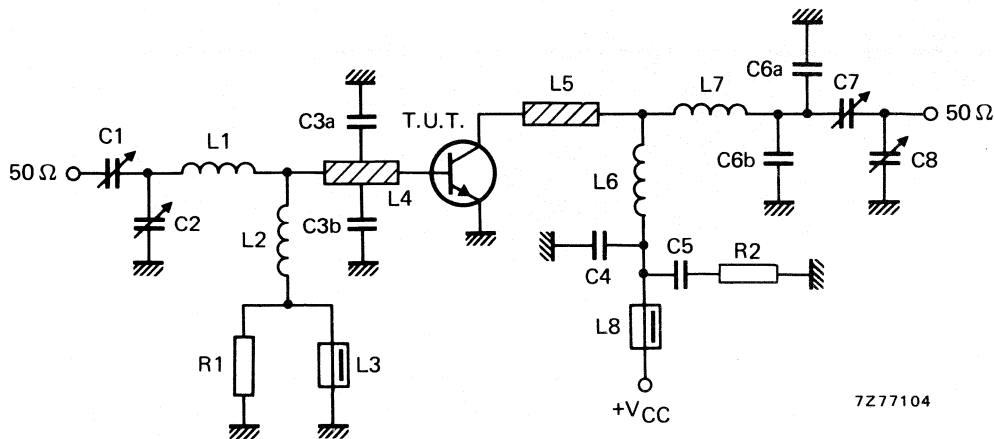


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C8 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C6a = C6b = 8,2 pF ceramic capacitor (500 V)

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 1 turn Cu wire (1,6 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L6 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 5,0 mm; length 6,0 mm; leads 2 x 5 mm

L7 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,5 mm; length 6,0 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10  $\Omega$  ( $\pm 10\%$ ) carbon resistor (0,25 W)R2 = 4,7  $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,25 W)

Component layout and printed-circuit board for 175 MHz test circuit are shown in Fig. 8.

## APPLICATION INFORMATION (continued)

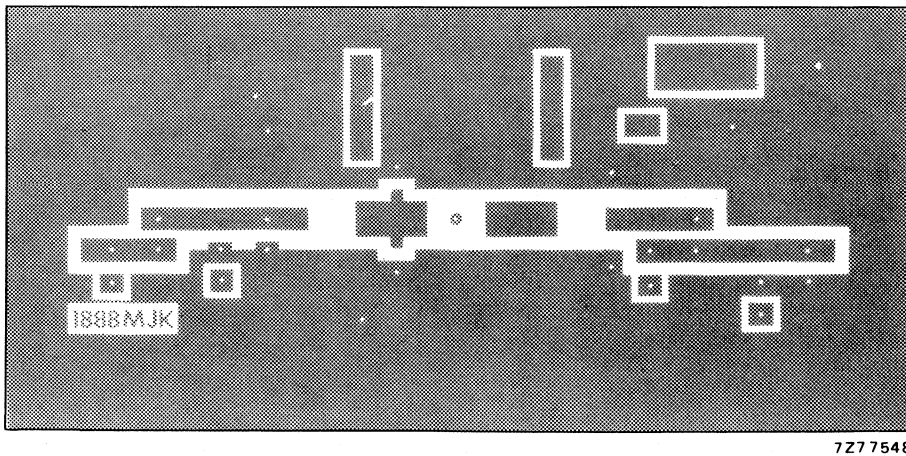
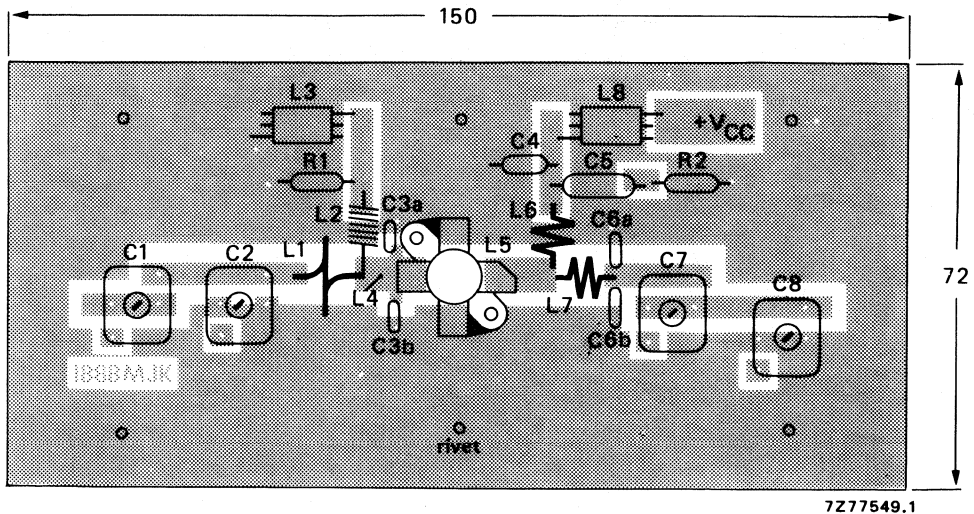


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

To minimize the dielectric losses, the ground plane under the interconnection of L7 and C7 has been removed.

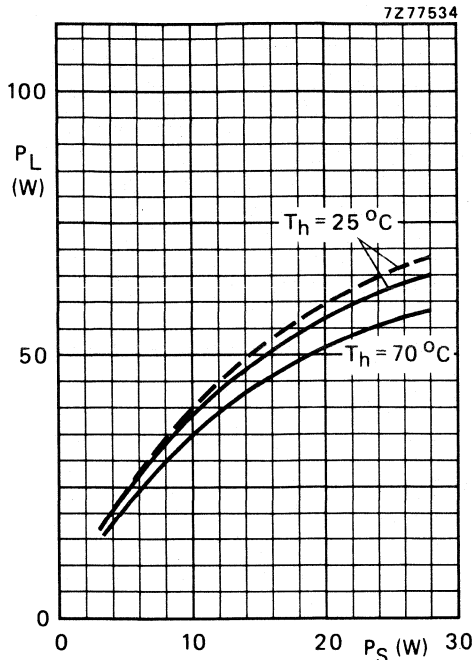


Fig. 9 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 12,5 \text{ V}$ ; ---  $V_{CE} = 13,5 \text{ V}$ .

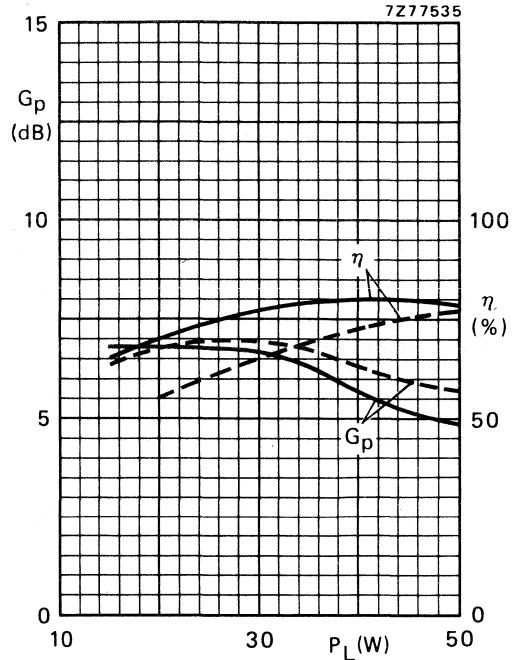


Fig. 10 Typical values;  $f = 175 \text{ MHz}$ ;  $T_h = 25 \text{ °C}$ ;  
 —  $V_{CE} = 12,5 \text{ V}$ ; ---  $V_{CE} = 13,5 \text{ V}$ .

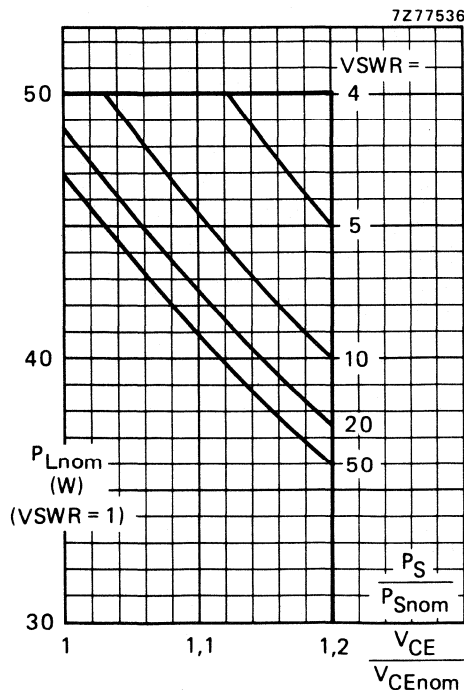


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ MHz}$ ;  $T_h = 70 \text{ °C}$ ;  
 $R_{th \text{ mb-h}} = 0,3 \text{ K/W}$ ;  $V_{CE \text{ nom}} = 12,5 \text{ V}$  or  $13,5 \text{ V}$ ;  
 $P_S = P_{S \text{ nom}}$  at  $V_{CE \text{ nom}}$  and  $V_{SWR} = 1$  (see page 5).

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $V_{SWR} = 1$ ), as a function of the expected supply over-voltage ratio with  $V_{SWR}$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{S \text{ nom}}$ ) increases linearly with supply over-voltage ratio.

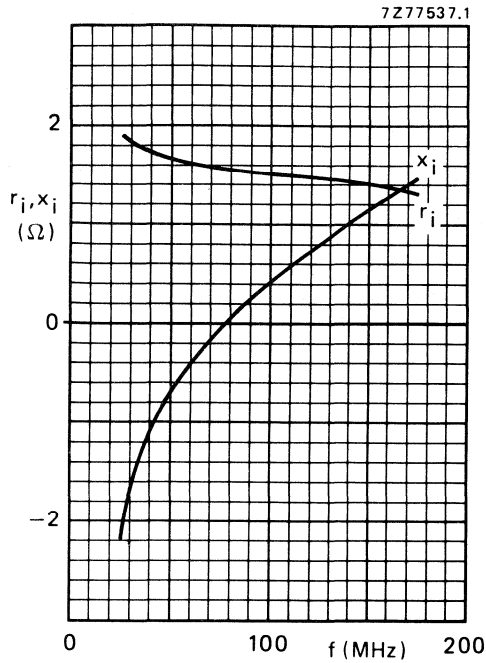


Fig. 12 Input impedance (series components).

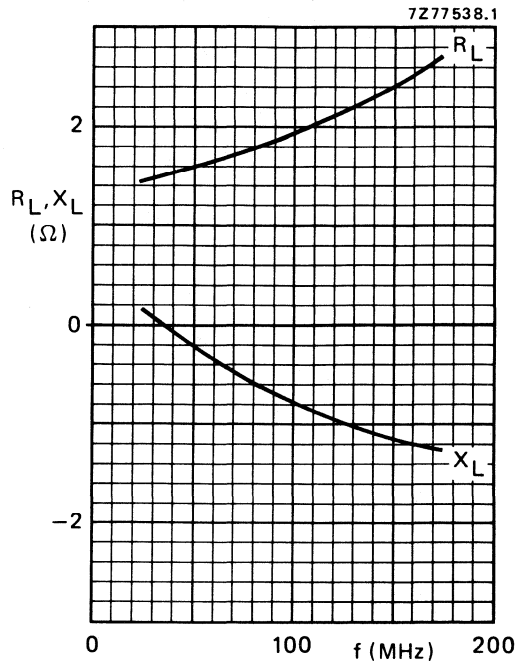


Fig. 13 Load impedance (series components).

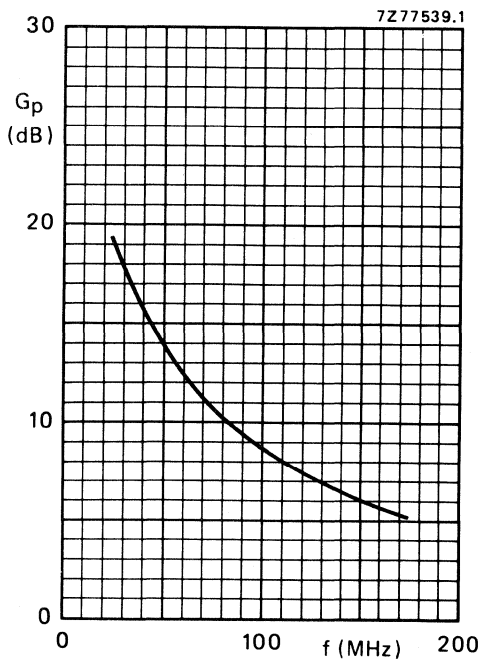


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 12,5 \text{ V}$ ;  $P_L = 45 \text{ W}$ ;  
class-B operation;  $T_h = 25 \text{ }^\circ\text{C}$ .

R.F. performance in s.s.b. class-AB operation

$V_{CE} = 12,5 \text{ V}$ ;  $T_h$  up to  $25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$   
 $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$\eta_{dt}$ %	$d_3$ dB*	$d_5$ dB*	$I_{C(ZS)}$ mA
3 to 30 (P.E.P.)	typ. 19,5	typ. 35	typ. -33	typ. -36	25

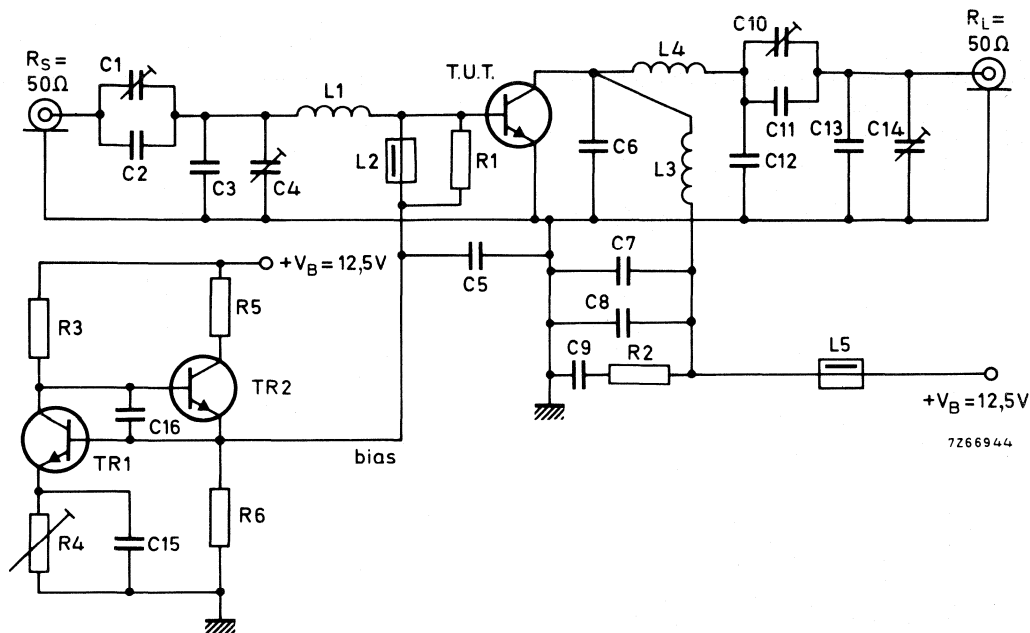


Fig. 15 Test circuit; s.s.b. class-AB.

List of components:

TR1 = TR2 = BD137

C1 = 100 pF air dielectric trimmer (single insulated rotor type)

C2 = 27 pF ceramic capacitor (500 V)

C3 = 180 pF polystyrene capacitor

C4 = 100 pF air dielectric trimmer (single non-insulated rotor type)

C5 = C7 = 3,9 nF polyester capacitor

C6 = 2 x 270 pF polystyrene capacitors in parallel

C8 = C15 = C16 = 100 nF polyester capacitor

C9 = 2,2  $\mu\text{F}$  moulded metallized polyester capacitor

C10 = 2 x 385 pF (sections in parallel) film dielectric trimmer

C11 = 68 pF ceramic capacitor (500 V)

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

## APPLICATION INFORMATION (continued)

List of components (continued)

C12 = 2 x 82 pF ceramic capacitors in parallel (500 V)

C13 = 47 pF ceramic capacitor (500 V)

C14 = 385 pF film dielectric trimmer

L1 = 88 nH; 3 turns Cu wire (1,0 mm); int. dia. 9 mm; length 6,1 mm; leads 2 x 5 mm

L2 = L5 = Ferroxcube choke coil (cat. no. 4312 020 36640)

L3 = 68 nH; 3 turns enamelled Cu wire (1,6 mm); int. dia. 8 mm; length 8,3 mm; leads 2 x 5 mm

L4 = 96 nH; 3 turns enamelled Cu wire (1,6 mm); int. dia. 10 mm; length 7,6 mm; leads 2 x 5 mm

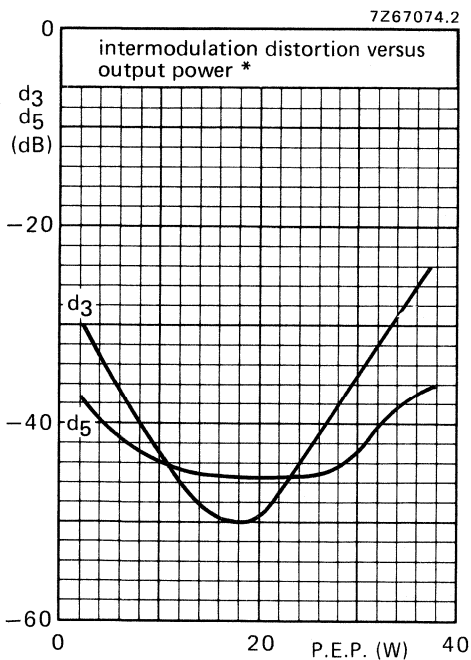
R1 = 27  $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,5 W)R2 = 4,7  $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,25 W)R3 = 1,5 k $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,5 W)R4 = 10  $\Omega$  wirewound potentiometer (3 W)R5 = 47  $\Omega$  wirewound resistor (5,5 W)R6 = 150  $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,25 W)

Fig. 16.

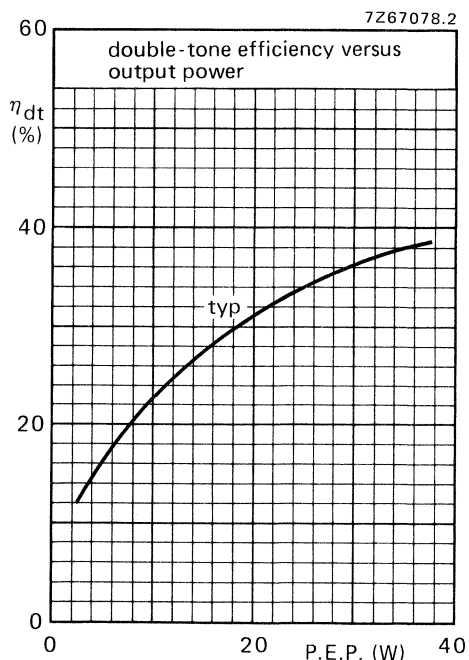


Fig. 17.

Conditions for Figs 16 and 17:

$V_{CE} = 12,5 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} \leq 0,3 \text{ }^\circ\text{K/W}$ ;  $I_{C(ZS)} = 25 \text{ mA}$ ; typical values.

\* See next page.

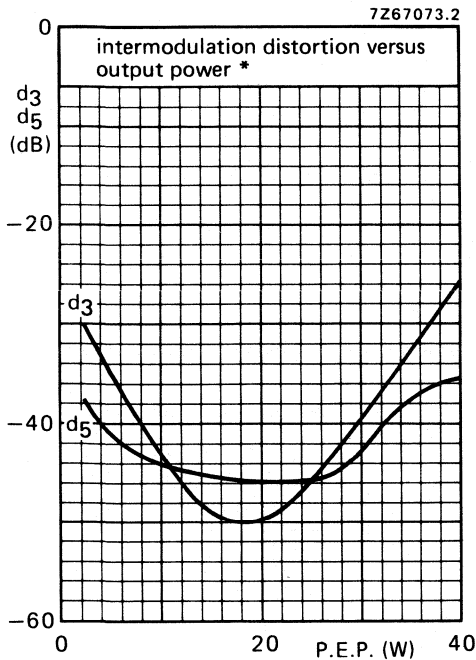


Fig. 18.

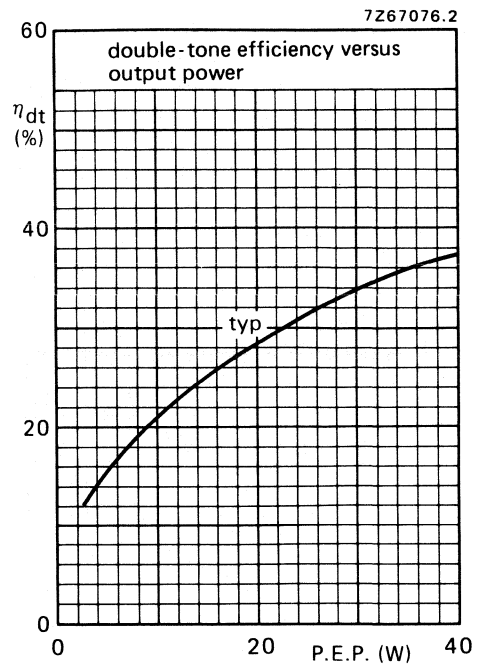


Fig. 19.

Conditions for Figs 18 and 19:

$V_{CE} = 13,5 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$ ;  $I_{C(ZS)} = 25 \text{ mA}$ ; typical values.

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

APPLICATION INFORMATION (continued)

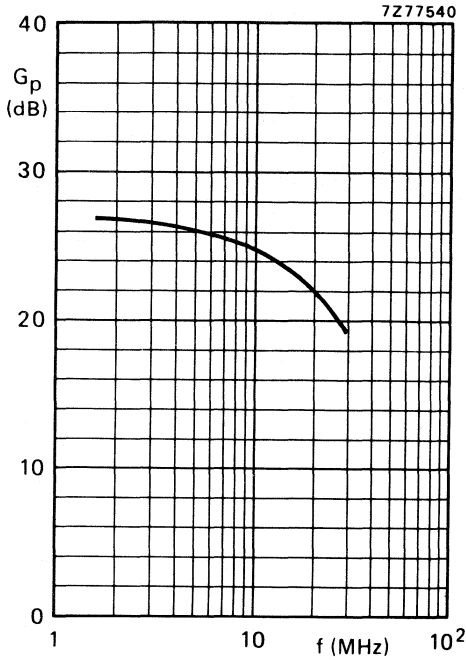


Fig. 20 Power gain as a function of frequency.

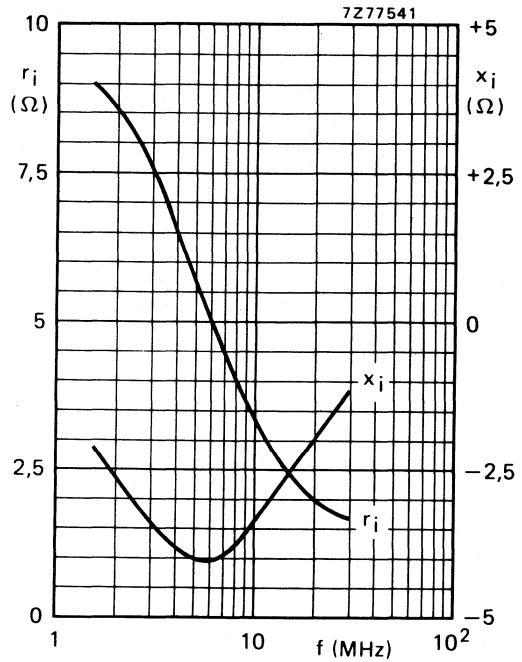


Fig. 21 Input impedance (series components) as a function of frequency.

Fig. 20 and 21 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 12,5 \text{ V}$   
 $P_L = 30 \text{ W (P.E.P.)}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$   
 $I_{C(ZS)} = 25 \text{ mA}$   
 $Z_L = 1,8 \text{ } \Omega$

$V_{CE} = 13,5 \text{ V}$   
 $P_L = 35 \text{ W (P.E.P.)}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} \leq 0,3 \text{ K/W}$   
 $I_{C(ZS)} = 25 \text{ mA}$   
 $Z_L = 1,8 \text{ } \Omega$



## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, AB and B operated h.f. and v.h.f. transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Matched  $h_{FE}$  groups are available on request. It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

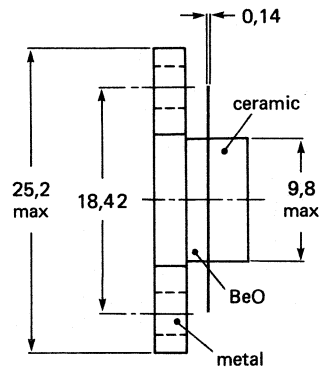
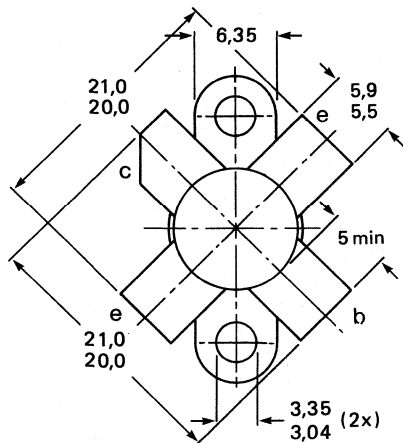
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS	$d_3$ dB
c.w. (class-B)	28	175	45	> 7,5	> 70	$0,7 + j1,3$	$110 - j62$	—
s.s.b. (class-AB)	28	1,6 – 28	5–47,5(P.E.P.)	typ. 19	typ. 45	—	—	typ. -30
s.s.b. (class-A)	26	1,6 – 28	17(P.E.P.)	typ. 22	—	—	—	typ. -42

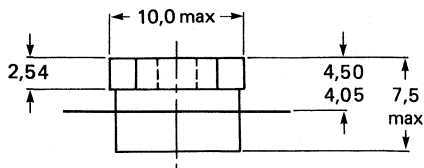
### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.



7Z77386.2



Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open-collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	4 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	12 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	105 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Operating junction temperature	$T_j$	max.	200 °C

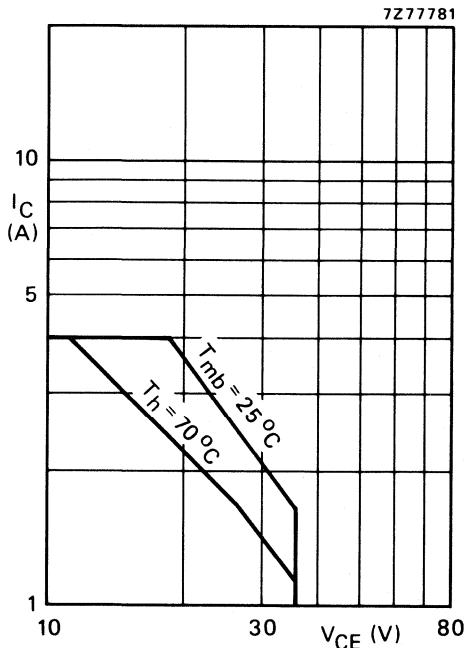


Fig. 2 D.C. SOAR.

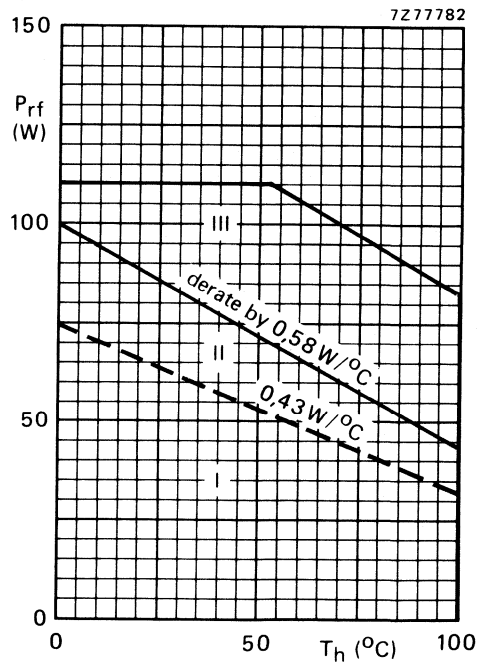


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  
 $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 45 W;  $T_{mb} = 83,5$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	2,65 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	1,95 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,3 K/W

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$$V_{BE} = 0; I_C = 25\text{ mA}$$

$$V_{(BR)CES} > 65\text{ V}$$

Collector-emitter breakdown voltage

$$\text{open base; } I_C = 100\text{ mA}$$

$$V_{(BR)CEO} > 36\text{ V}$$

Emitter-base breakdown voltage

$$\text{open collector; } I_E = 10\text{ mA}$$

$$V_{(BR)EBO} > 4\text{ V}$$

Collector cut-off current

$$V_{BE} = 0; V_{CE} = 36\text{ V}$$

$$I_{CES} < 10\text{ mA}$$

Second breakdown energy;  $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$

open base

$$E_{SBO} > 8\text{ mJ}$$

$$R_{BE} = 10\ \Omega$$

$$E_{SBR} > 8\text{ mJ}$$

D.C. current gain\*

$$I_C = 2,5\text{ A}; V_{CE} = 5\text{ V}$$

$$h_{FE} \text{ typ. } 45 \\ 10 \text{ to } 80$$

D.C. current gain ratio of matched devices\*

$$I_C = 2,5\text{ A}; V_{CE} = 5\text{ V}$$

$$h_{FE1}/h_{FE2} < 1,2$$

Collector-emitter saturation voltage\*

$$I_C = 7,5\text{ A}; I_B = 1,5\text{ A}$$

$$V_{CEsat} \text{ typ. } 1,5\text{ V}$$

Transition frequency at  $f = 100\text{ MHz}$ \*

$$-I_E = 2,5\text{ A}; V_{CB} = 28\text{ V}$$

$$f_T \text{ typ. } 570\text{ MHz}$$

$$-I_E = 7,5\text{ A}; V_{CB} = 28\text{ V}$$

$$f_T \text{ typ. } 570\text{ MHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 28\text{ V}$$

$$C_c \text{ typ. } 82\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$$

$$C_{re} \text{ typ. } 54\text{ pF}$$

Collector-flange capacitance

$$C_{cf} \text{ typ. } 2\text{ pF}$$

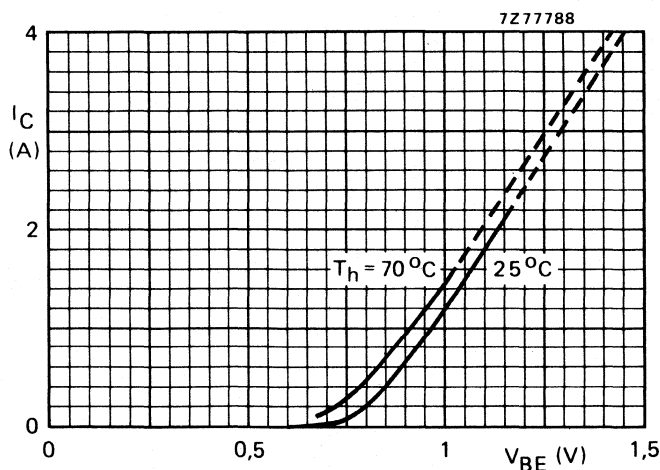


Fig. 4 Typical values;  $V_{CE} = 28\text{ V}$ .

\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}$ ;  $\delta \leq 0,02$ .

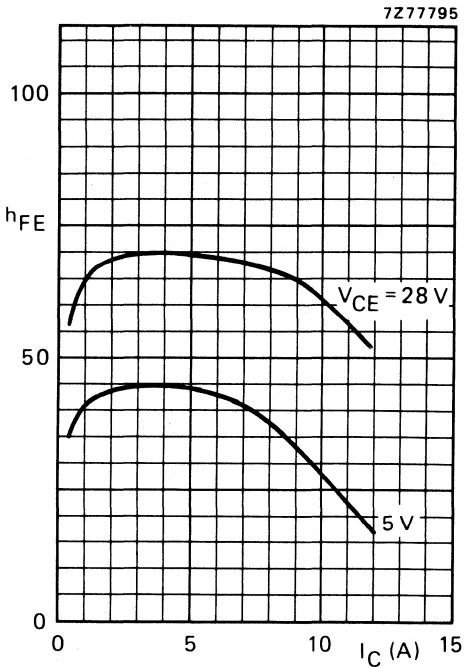


Fig. 5 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

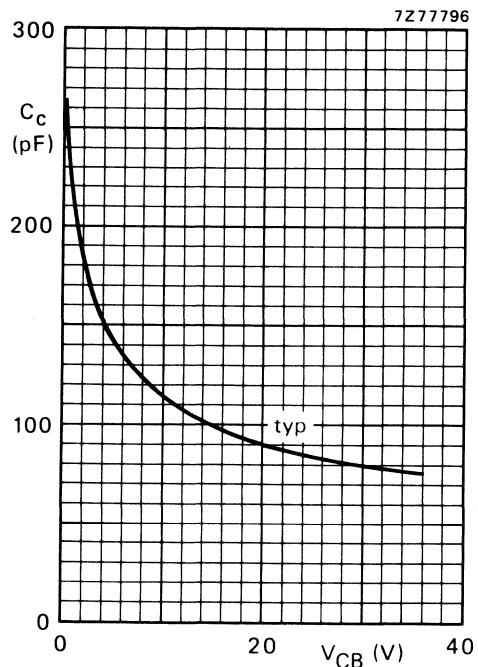


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

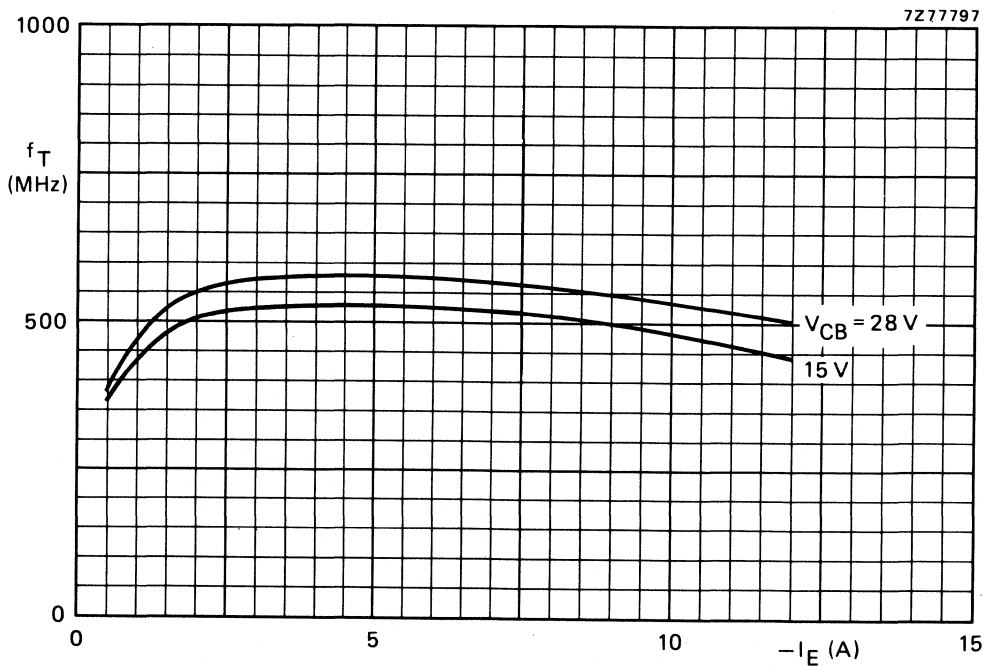


Fig. 7 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	28	45	< 8	> 7,5	< 2,47	> 70	$0,7 + j1,3$	$110 - j62$

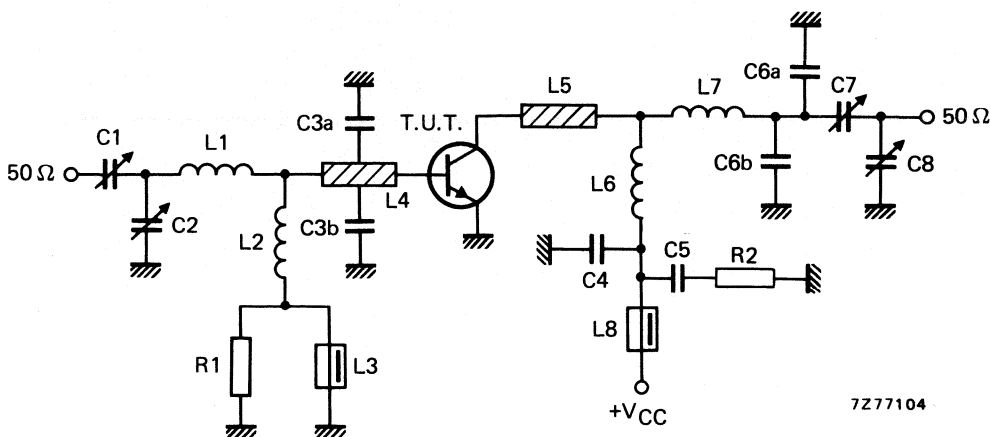


Fig. 8 Test circuit; c.w. class-B.

List of components:

C1 = C7 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor

C5 = 100 nF polyester capacitor

C6a = 2,2 pF ceramic capacitor (500 V)

C6b = 1,8 pF ceramic capacitor (500 V)

C8 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

L1 = 14 nH; 1 turn Cu wire (1,6 mm); int. dia. 7,7 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L6 = 80 nH; 3 turns Cu wire (1,6 mm); int. dia. 9,0 mm; length 8,0 mm; leads 2 x 5 mm

L7 = 62 nH; 3 turns Cu wire (1,6 mm); int. dia. 7,5 mm; length 8,1 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 9.

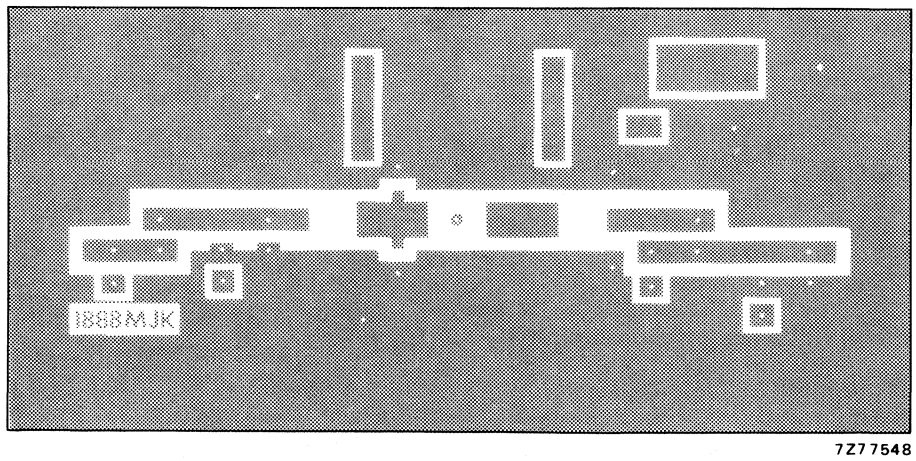
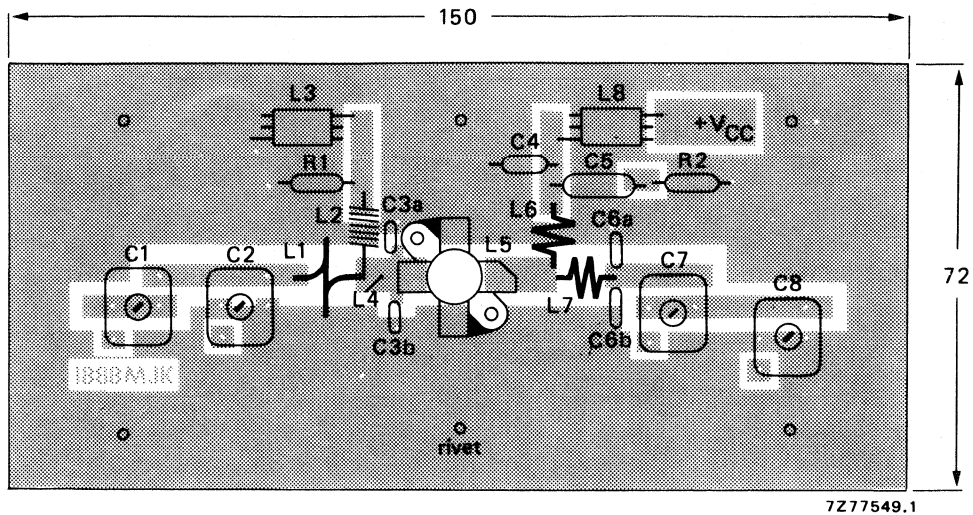


Fig. 9 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

To minimize the dielectric losses, the ground plane under the interconnection of L7 and C7 has been removed.

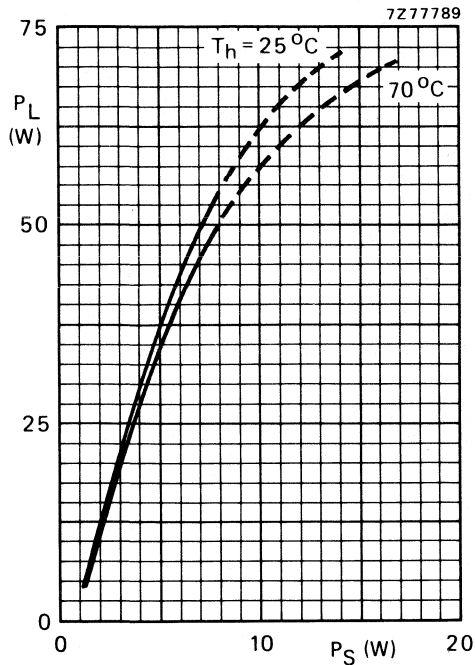


Fig. 10 Typical values;  $V_{CE} = 28 \text{ V}$ ;  $f = 175 \text{ MHz}$ .

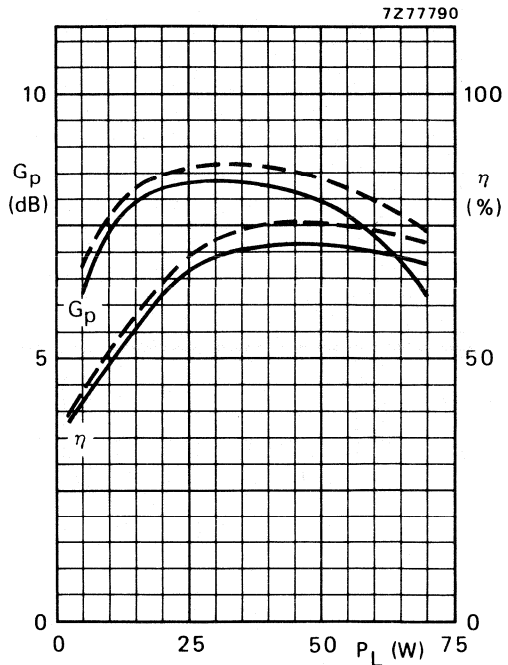


Fig. 11 Typical values;  $V_{CE} = 28 \text{ V}$ ;  $f = 175 \text{ MHz}$ ; ---  $T_h = 25 \text{ }^\circ\text{C}$ ; —  $T_h = 70 \text{ }^\circ\text{C}$ .

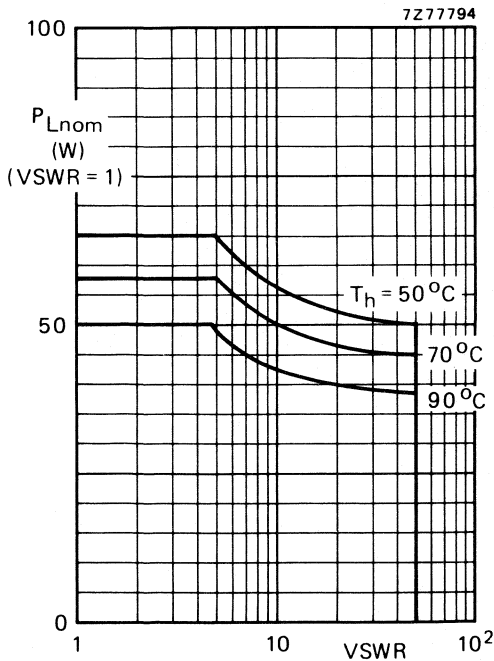


Fig. 12 R.F. SOAR; c.w. class-B operation;  $f = 175 \text{ MHz}$ ;  $V_{CE} = 28 \text{ V}$ ;  $R_{th \text{ mb-h}} = 0,3 \text{ K/W}$ . The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

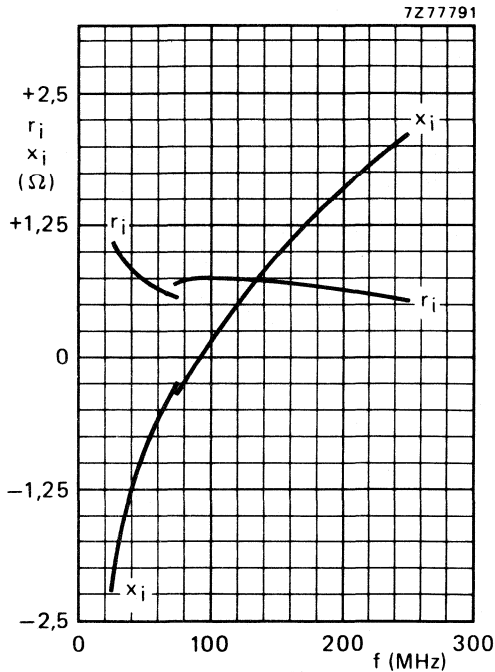


Fig. 13 Input impedance (series components).

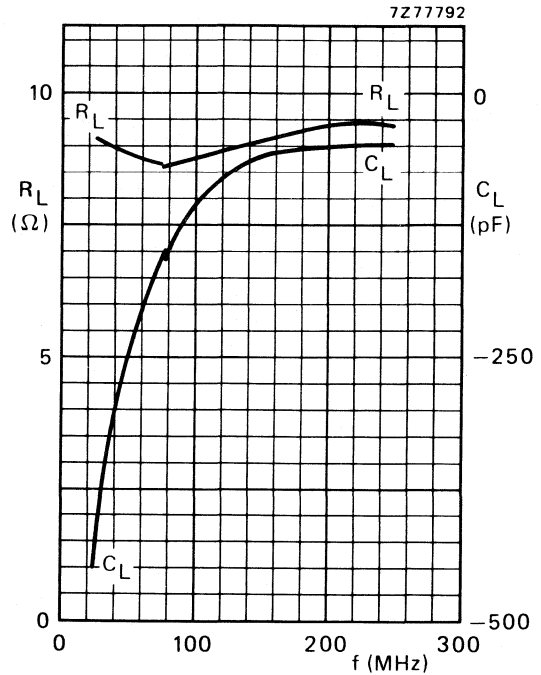


Fig. 14 Load impedance (parallel components).

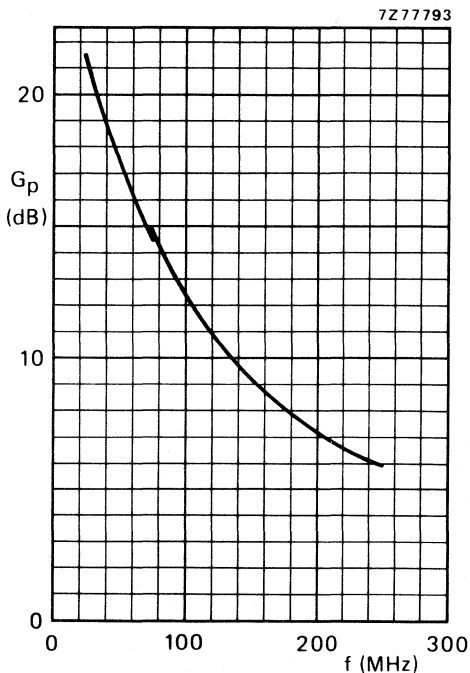


Fig. 15 Power gain versus frequency.

**OPERATING NOTE**

Below 75 MHz a base-emitter resistor of  $10 \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

Conditions for Figs 13; 14 and 15.

Typical values;  $V_{CE} = 28 \text{ V}$ ;  $P_L = 45 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .



R.F. performance in s.s.b. class-AB operation (linear power amplifier)

$V_{CE} = 28 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$\eta_{dt}$ (%) at 47,5 W (P.E.P.)	$I_C$ (A) at 47,5 W (P.E.P.)	$d_3$ dB*	$d_5$ dB*	$I_{C(ZS)}$ mA	$T_h$ °C
5 to 47,5 (P.E.P.)	typ. 19	typ. 45	typ. 1,9	typ. -30	< -30	50	25
5 to 42,5 (P.E.P.)	typ. 19	—	—	typ. -30	< -30	50	70

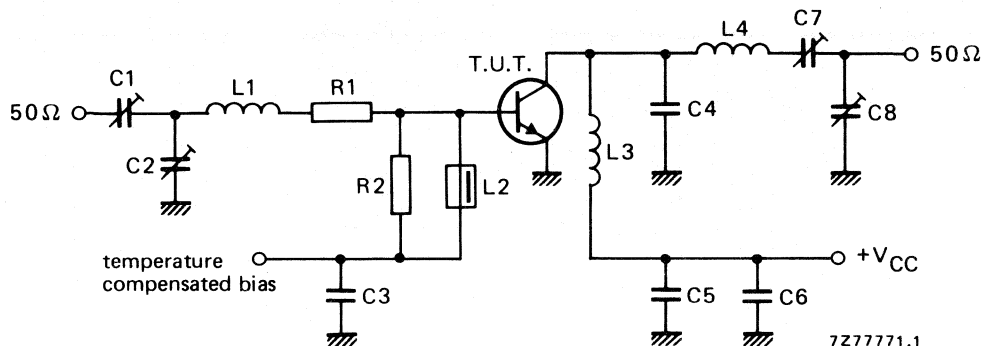


Fig. 16 Test circuit; s.s.b. class-AB.

List of components:

C1 = C2 = 10 to 780 pF film dielectric trimmer

C3 = C5 = C6 = 220 nF polyester capacitor

C4 = 56 pF ceramic capacitor (500 V)

C7 = C8 = 15 to 575 pF film dielectric trimmer

L1 = 4 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 7,0 mm; leads 2 x 5 mm

L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 4 turns enamelled Cu wire (1,6 mm); int. dia. 10 mm; length 9,4 mm; leads 2 x 5 mm

L4 = 7 turns enamelled Cu wire (1,6 mm); int. dia. 12 mm; length 17,2 mm; leads 2 x 5 mm

R1 = 1,2 Ω; parallel connection of 4 x 4,7 Ω carbon resistors

R2 = 39 Ω carbon resistor

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

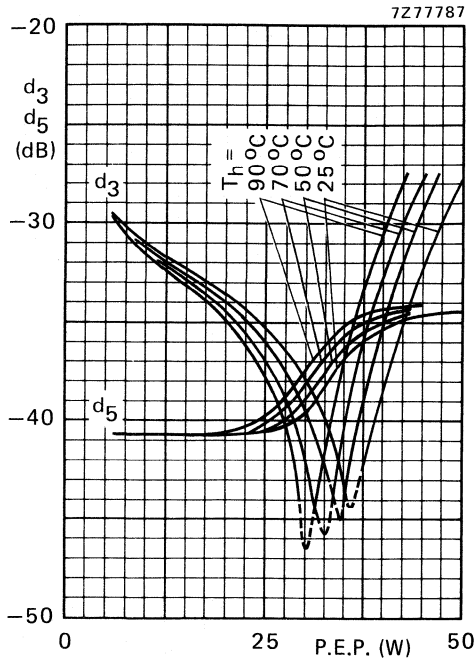


Fig. 17 Intermodulation distortion as a function of output power.\*

Conditions for Fig. 17:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ; typical values.

Conditions for Fig. 18:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; typical values.

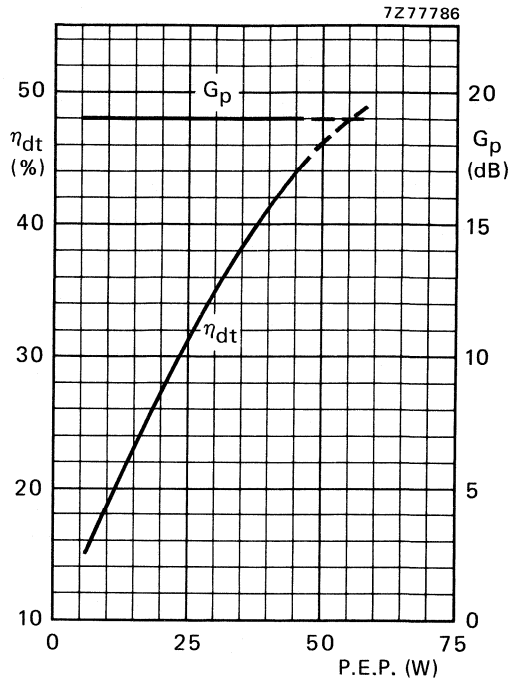


Fig. 18 Double-tone efficiency and power gain as a function of output power.

\* See note on previous page.

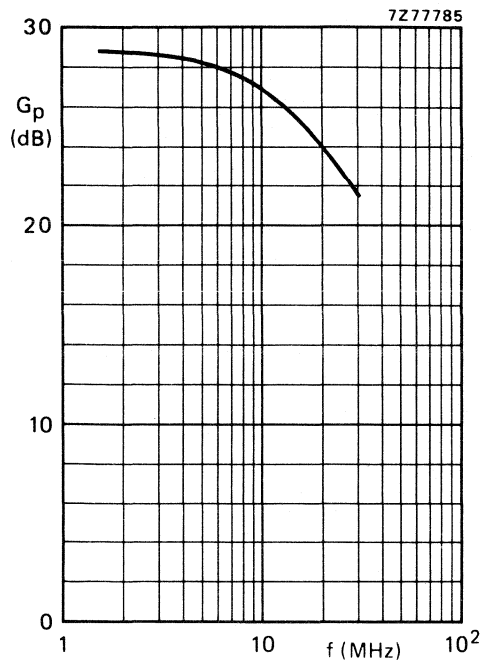


Fig. 19 Power gain as a function of frequency.

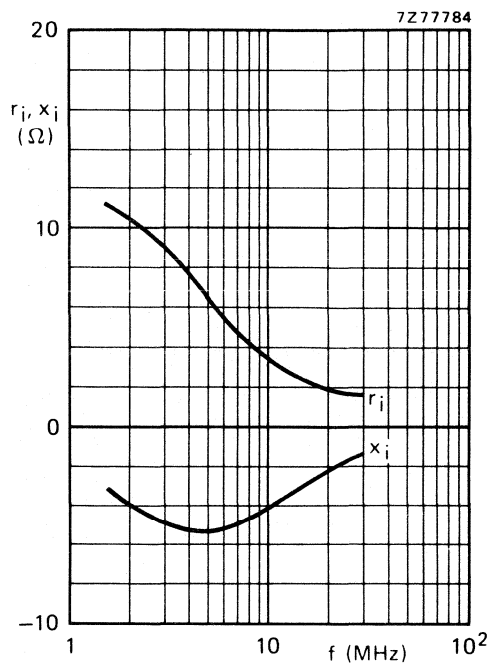


Fig. 20 Input impedance (series components) as a function of frequency.

Figs 19 and 20 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $P_L = 47,5 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 6,4 \text{ } \Omega$ .

#### Ruggedness in s.s.b. operation

The BLW86 is capable of withstanding a load mismatch (VSWR = 50) under the following conditions: class-AB operation;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $V_{CE} = 28 \text{ V}$ ;  $T_h = 70 \text{ }^\circ\text{C}$  and  $P_{Lnom} = 50 \text{ W P.E.P.}$

R.F. performance in s.s.b. class-A operation (linear power amplifier)

$V_{CE} = 26 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$I_C$ A	$d_3$ dB*	$d_5$ dB*	$T_h$ °C
17 (P.E.P.)	typ. 22	1,7	typ. -40	< -40	70
17 (P.E.P.)	typ. 22	1,7	typ. -42	< -40	25

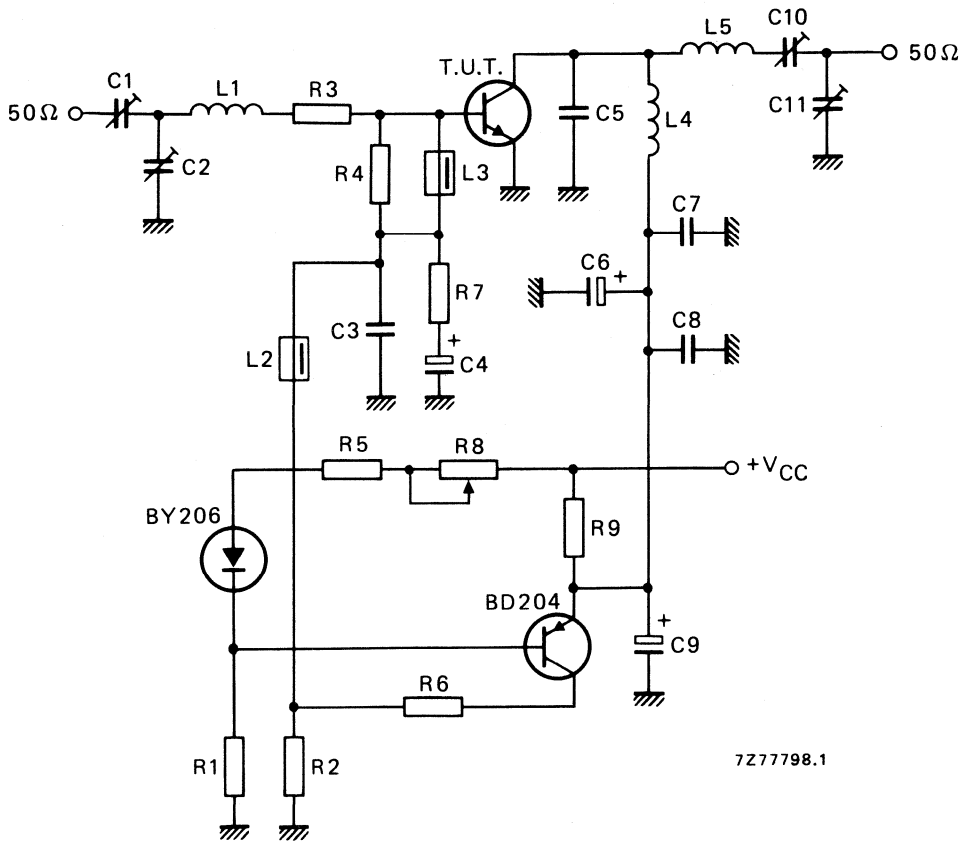


Fig. 21 Test circuit; s.s.b. class-A.

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

List of components in Fig. 21:

- C1 = C2 = 10 to 780 pF film dielectric trimmer
- C3 = 22 nF ceramic capacitor (63 V)
- C4 = 47  $\mu$ F/10 V electrolytic capacitor
- C5 = 56 pF ceramic capacitor (500 V)
- C6 = 47  $\mu$ F/35 V electrolytic capacitor
- C7 = C8 = 220 nF polyester capacitor
- C9 = 10  $\mu$ F/35 V electrolytic capacitor
- C10 = 10 to 210 pF film dielectric trimmer
- C11 = 15 to 575 pF film dielectric trimmer

L1 = 3 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L2 = L3 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = 11 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 11,0 mm

L5 = 14 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 11,0 mm

R1 = 600  $\Omega$ ; parallel connection of 2 x 1,2 k $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,5 W each)

R2 = 15  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,25 W)

R3 = 1,2  $\Omega$ ; parallel connection of 4 x 4,7  $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,125 W each)

R4 = 33  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,25 W)

R5 = 18  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,25 W)

R6 = 120  $\Omega$  wirewound resistor ( $\pm 5\%$ ; 5,5 W)

R7 = 1  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,125 W)

R8 = 47  $\Omega$  wirewound potentiometer (3 W)

R9 = 1,57  $\Omega$ ; parallel connection of 3 x 4,7  $\Omega$  wirewound resistors ( $\pm 5\%$ ; 5,5 W each)

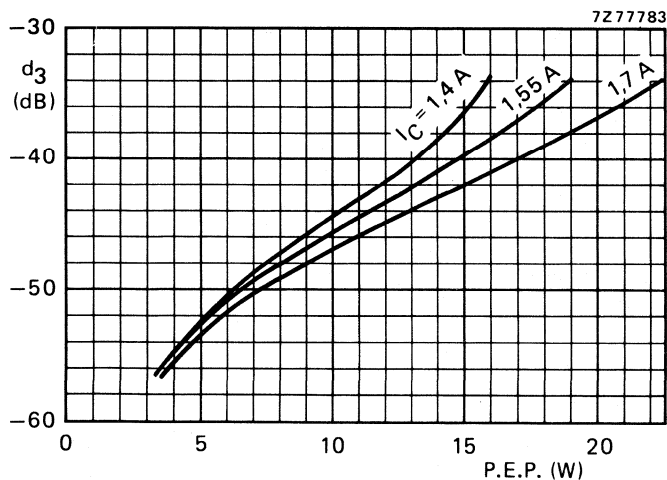


Fig. 22 Intermodulation distortion as a function of output power.  
Typical values;  $V_{CE} = 26$  V;  $T_h = 70$  °C;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz.



## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile h.f. and v.h.f. transmitters with a nominal supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

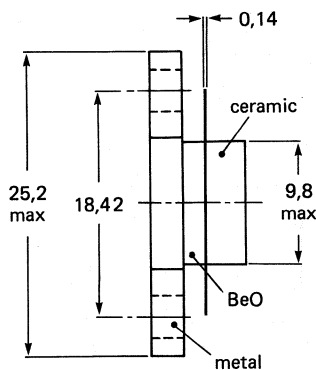
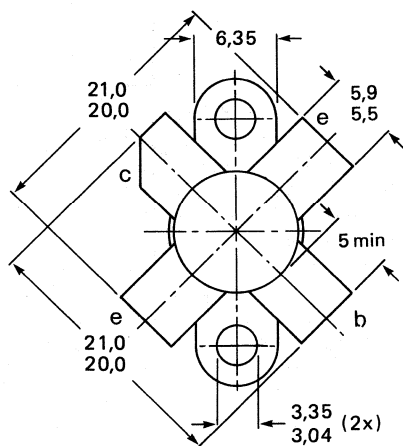
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	25	> 6	> 70	$1,6 + j1,4$	$210 + j5,5$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-123.

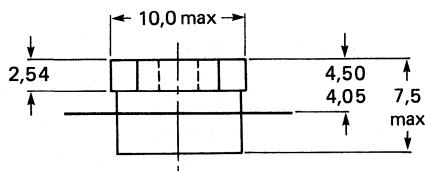


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Torque on screw: min. 0,6 Nm (6 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head  
4-40 UNC/2A

Heatsink compound must be applied sparingly  
and evenly distributed.



**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value

$V_{CESM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_C(AV)$  max. 6 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 12 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 76 W

Storage temperature

$T_{stg}$  - 65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

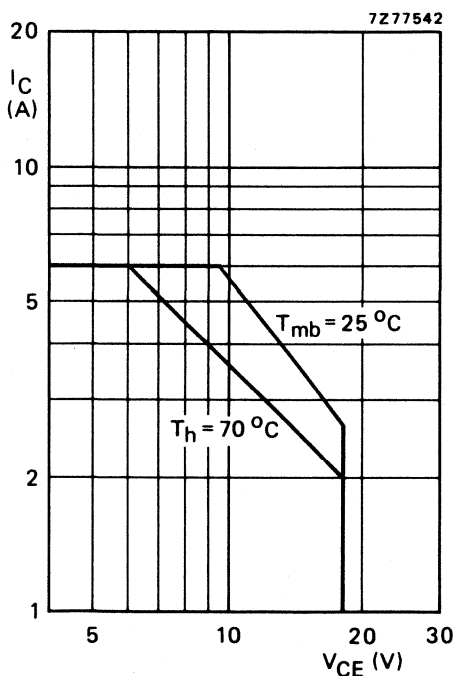


Fig. 2 D.C. SOAR.

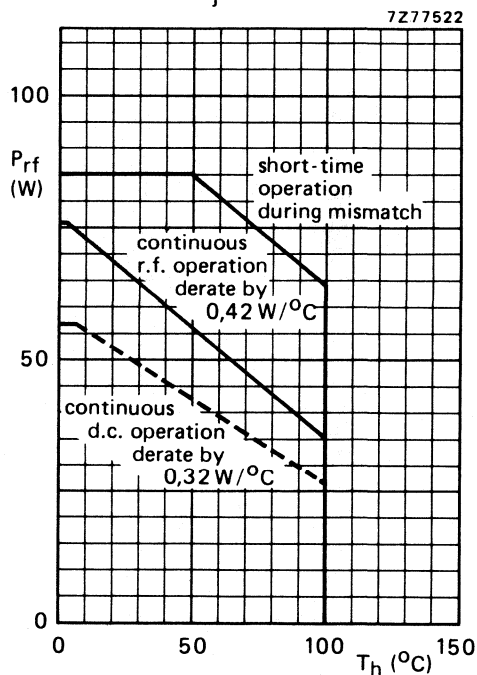


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f \geq 1$  MHz.

**THERMAL RESISTANCE** (dissipation = 20 W;  $T_{mb} = 76$  °C; i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th\ j-mb(dc)}$  = 3,0 K/W

From junction to mounting base (r.f. dissipation)

$R_{th\ j-mb(rf)}$  = 2,25 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,3 K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 25\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 10\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\ \Omega$  $E_{SBO} > 8\text{ mJ}$  $E_{SBR} > 8\text{ mJ}$ 

D.C. current gain\*

 $I_C = 2,5\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 50  
10 to 80

Collector-emitter saturation voltage\*

 $I_C = 7,5\text{ A}; I_B = 1,5\text{ A}$  $V_{CEsat}$  typ. 1,7 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 2,5\text{ A}; V_{CB} = 13,5\text{ V}$  $-I_E = 7,5\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 800 MHz $f_T$  typ. 750 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 15\text{ V}$  $C_C$  typ. 65 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 15\text{ V}$  $C_{re}$  typ. 41 pF

Collector-flange capacitance

 $C_{cf}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}; \delta \leq 0,02$ .

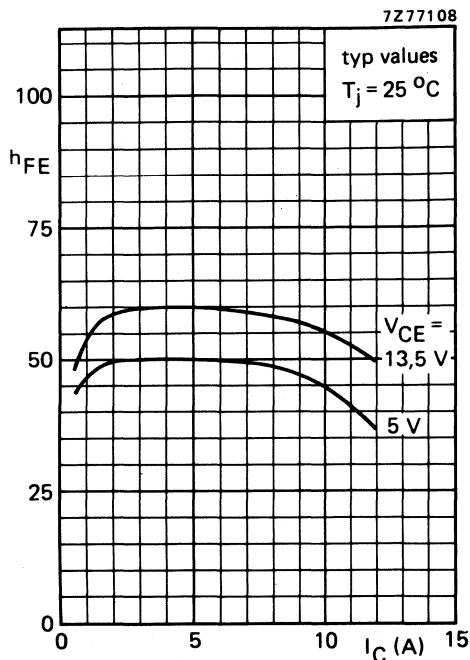


Fig. 4.

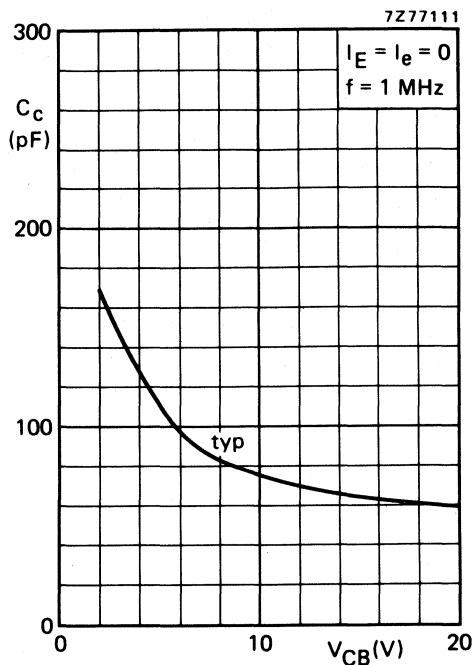


Fig. 5  $T_j = 25^\circ\text{C}$ .

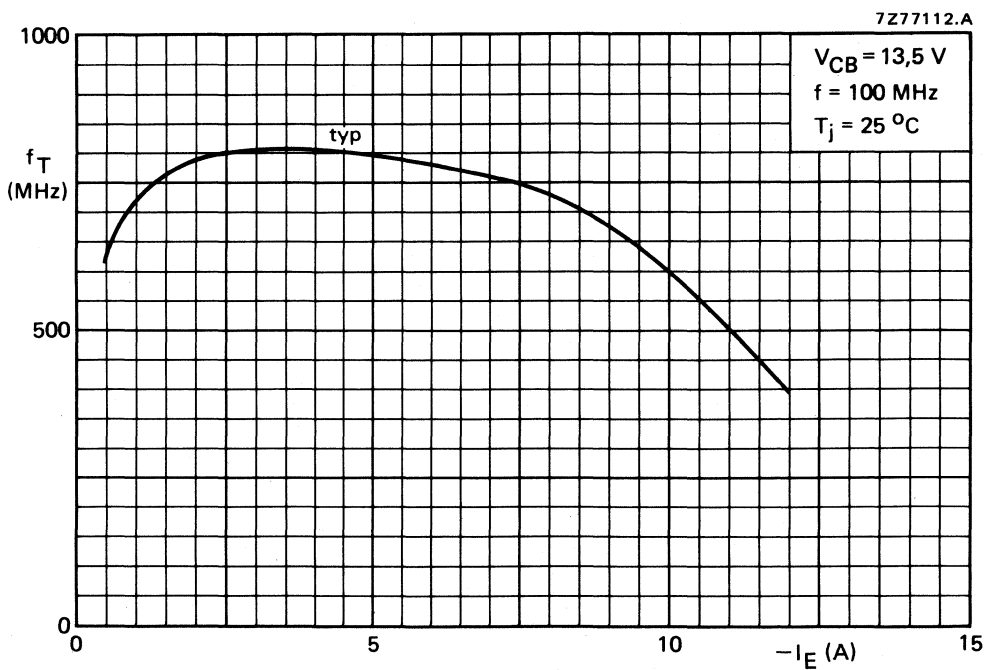


Fig. 6.

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	13,5	25	< 6,25	> 6	< 2,64	> 70	1,6 + j1,4	210 + j5,5
175	12,5	25	—	typ. 6,6	—	typ. 75	—	—

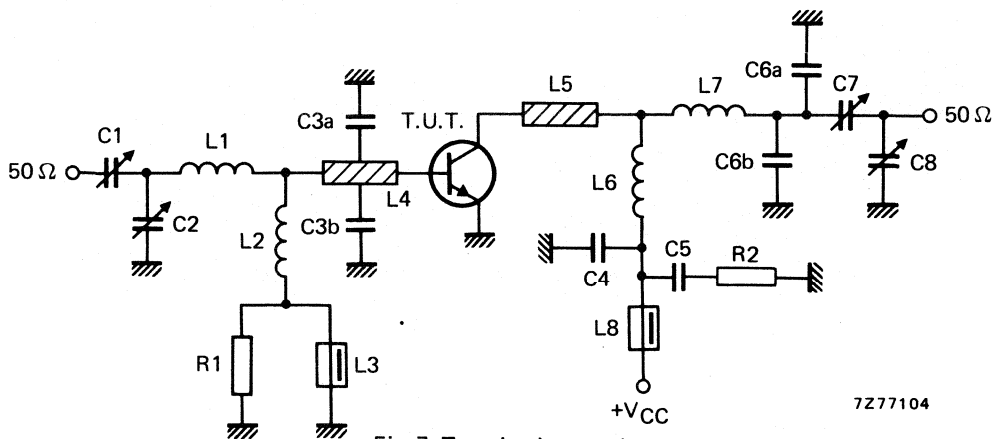


Fig. 7 Test circuit; c.w. class-B.

List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C8 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C6a = C6b = 8,2 pF ceramic capacitor (500 V)

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 1 turn Cu wire (1,6 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L6 = 2 turns Cu wire (1,6 mm); int. dia. 5,0 mm; length 6,0 mm; leads 2 x 5 mm

L7 = 2 turns Cu wire (1,6 mm); int. dia. 4,5 mm; length 6,0 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10  $\Omega$  ( $\pm 10\%$ ) carbon resistor (0,25 W)R2 = 4,7  $\Omega$  ( $\pm 5\%$ ) carbon resistor (0,25 W)

Component layout and printed-circuit board for 175 MHz test circuit are shown in Fig. 8.

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## APPLICATION INFORMATION (continued)

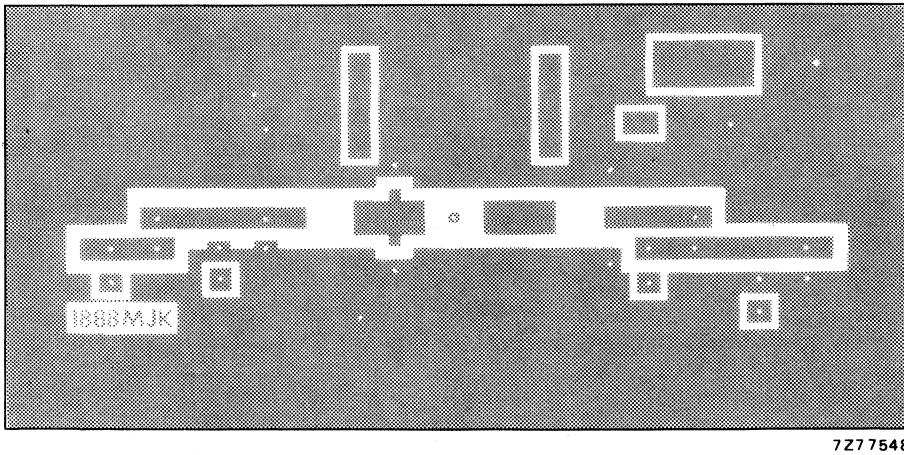
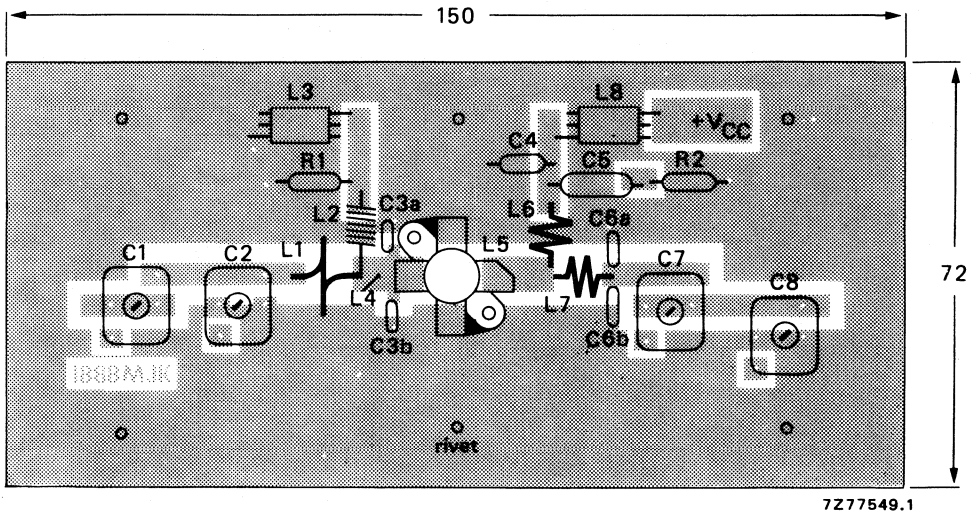


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

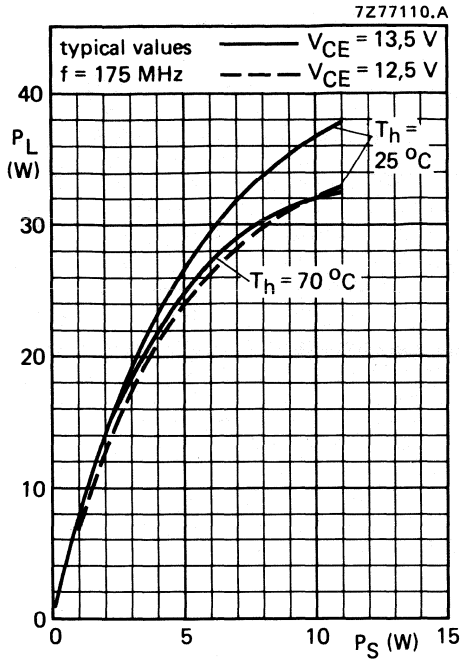


Fig. 9.

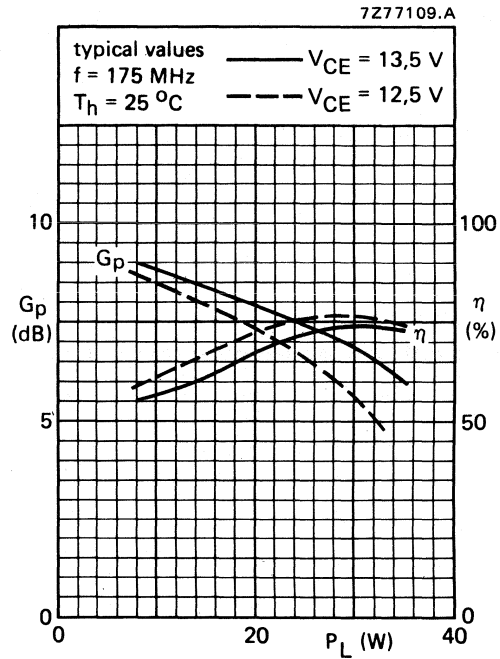


Fig. 10.

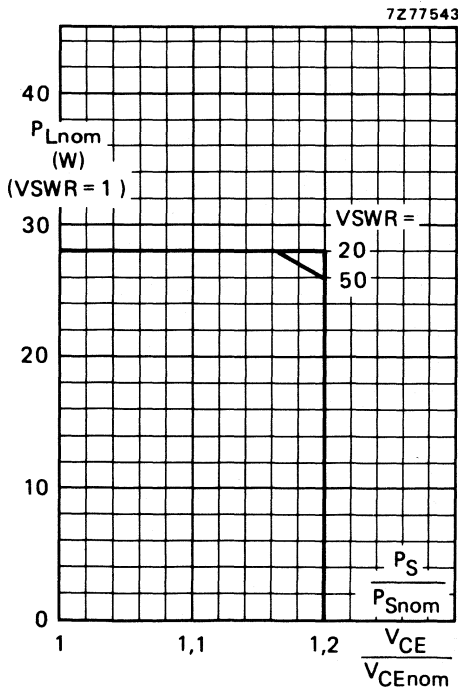
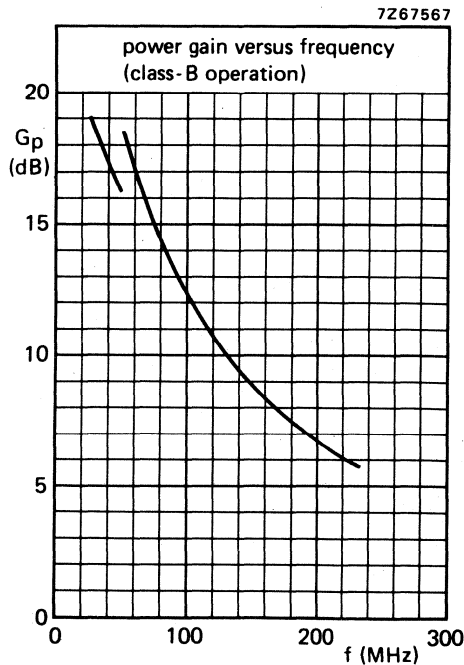
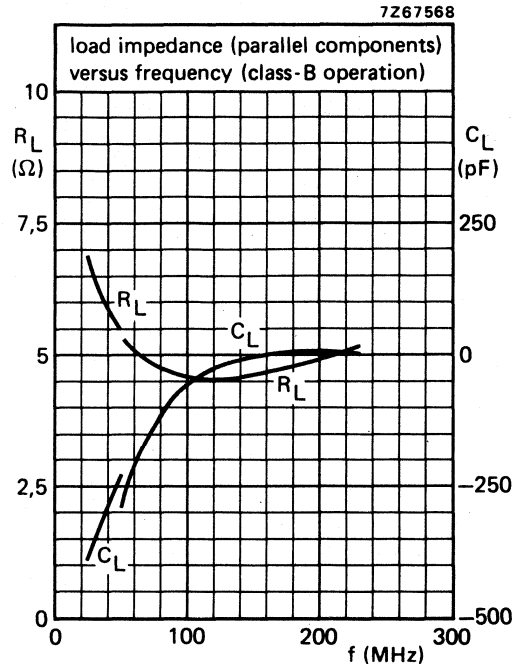
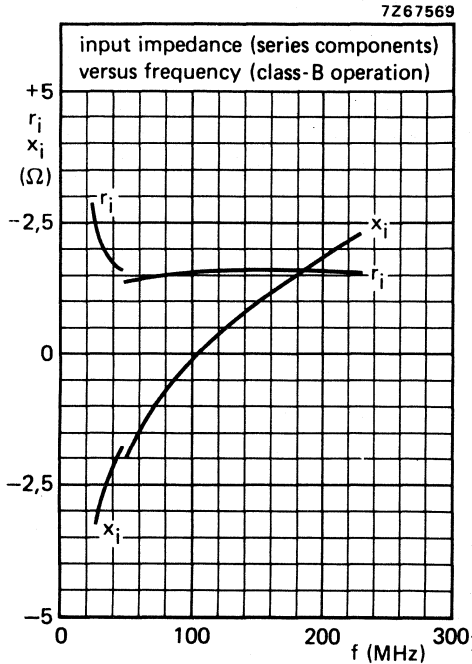


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,3 \text{ K/W}$ ;  $V_{CEnom} = 13,5 \text{ V}$  or  $12,5 \text{ V}$ ;  $P_S = P_{Snom}$  at  $V_{CEnom}$  and VSWR = 1 (see page 5).

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions (VSWR = 1), as a function of the expected supply over-voltage ratio with VSWR as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 50 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.



Conditions for Figs 12, 13 and 14:  
 Typical values;  $V_{CE} = 13,5\text{ V}$ ;  $P_L = 25\text{ W}$ ;  
 $T_h = 25\text{ }^\circ\text{C}$ .

## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor suitable for transmitting applications in class-A, B or C in the u.h.f. and v.h.f. range for a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand infinite VSWR at rated output power. High reliability is ensured by a **gold sandwich metallization**.

The transistor is housed in a ¼" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

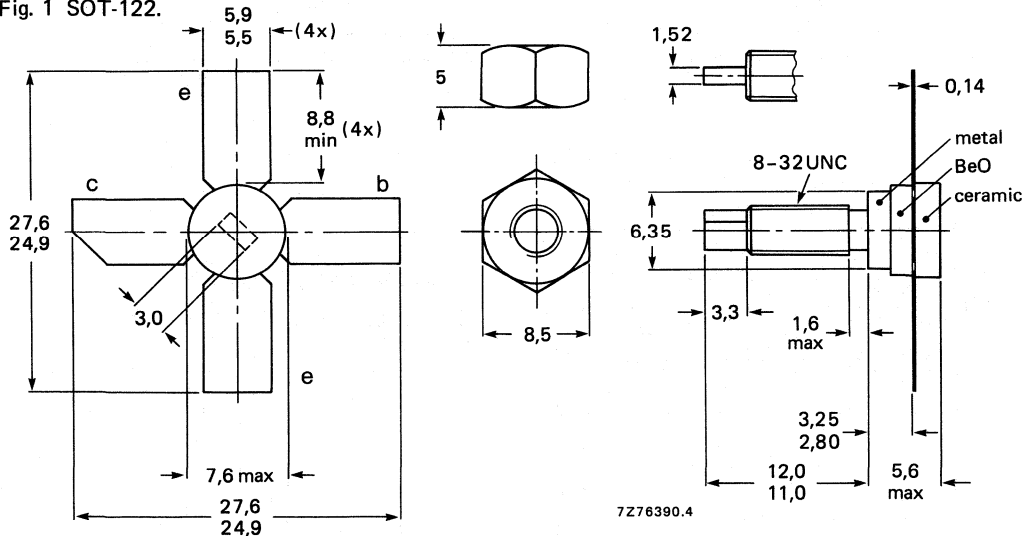
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %
c.w.	28	470	2	> 12	> 50

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or  
countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage

(peak value);  $V_{BE} = 0$

open base

$V_{CESM}$  max. 60 V

$V_{CEO}$  max. 30 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current

d.c. or average

$I_C; I_{C(AV)}$  max. 0,32 A

(peak value);  $f > 1$  MHz

$I_{CM}$  max. 1,0 A

Total power dissipation (d.c. and r.f.) up to  $T_{mb} = 50$  °C

$P_{tot}$  max. 9,6 W

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

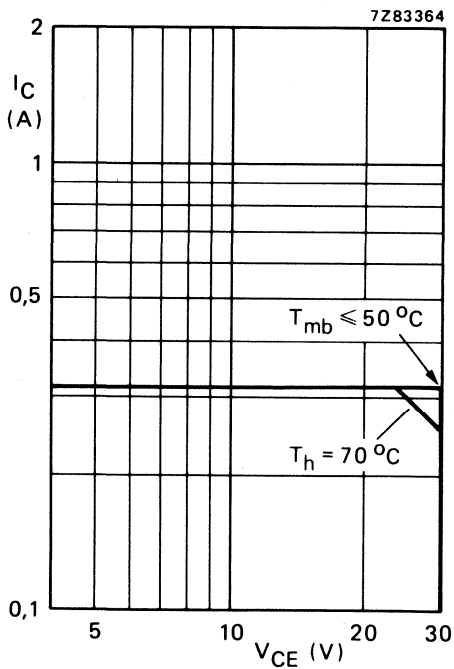


Fig. 2 D.C. SOAR.

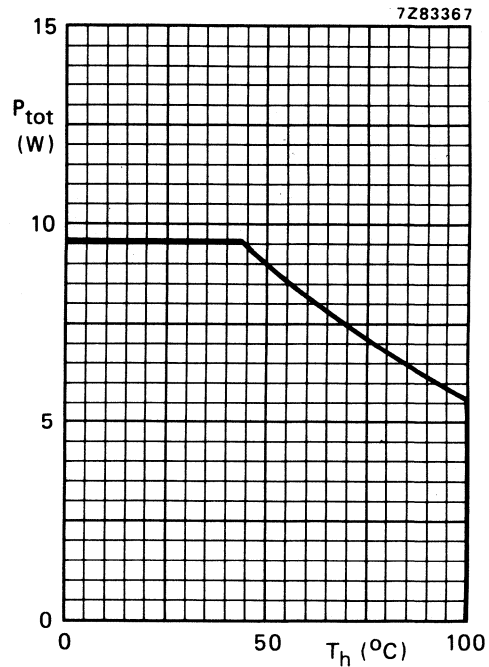


Fig. 3 Power derating curve vs. temperature.

**THERMAL RESISTANCE** (dissipation = 3,5 W;  $T_{mb} = 72$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base

(d.c. and r.f. dissipation)

$R_{th\ j-mb} = 13,0$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0,6$  K/W



**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 2\text{ mA}$

$V_{(BR)CES} > 60\text{ V}$

Collector-emitter breakdown voltage

open base;  $I_C = 10\text{ mA}$

$V_{(BR)CEO} > 30\text{ V}$

Emitter-base breakdown voltage

open collector;  $I_E = 1\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0; V_{CE} = 30\text{ V}$

$I_{CES} < 1\text{ mA}$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$

open base

$R_{BE} = 10\text{ }\Omega$

$E_{SBO} > 0,5\text{ mJ}$

$E_{SBR} > 0,5\text{ mJ}$

D.C. current gain \*

$I_C = 0,15\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE}$  typ. 40  
10 to 100

Collector-emitter saturation voltage \*

$I_C = 0,5\text{ A}; I_B = 0,1\text{ A}$

$V_{CEsat}$  typ. 0,9 V

Transition frequency at  $f = 500\text{ MHz}$  \*

$-I_E = 0,15\text{ A}; V_{CB} = 28\text{ V}$

$-I_E = 0,50\text{ A}; V_{CB} = 28\text{ V}$

$f_T$  typ. 1,20 GHz

$f_T$  typ. 0,85 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 28\text{ V}$

$C_c$  typ. 5,5 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 10\text{ mA}; V_{CE} = 28\text{ V}$

$C_{re}$  typ. 2 pF

Collector-stud capacitance

$C_{cs}$  typ. 1,2 pF

\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

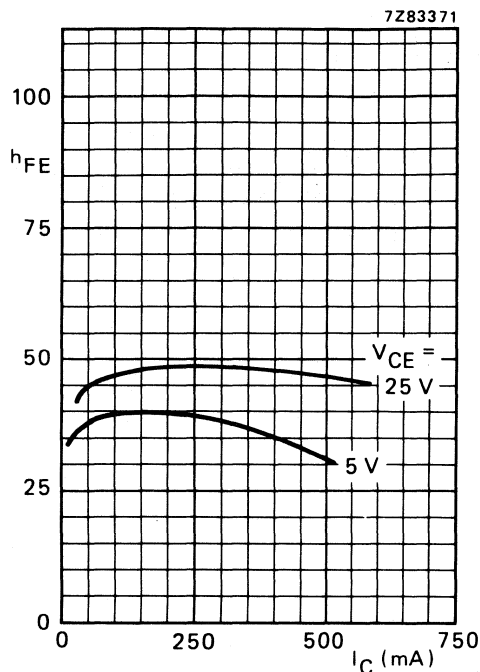


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

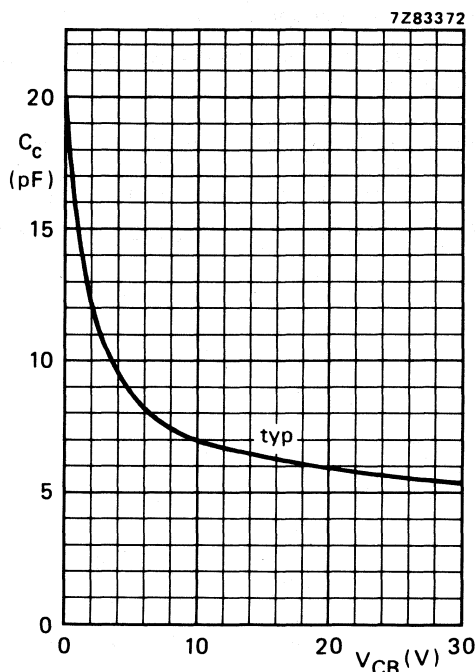


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

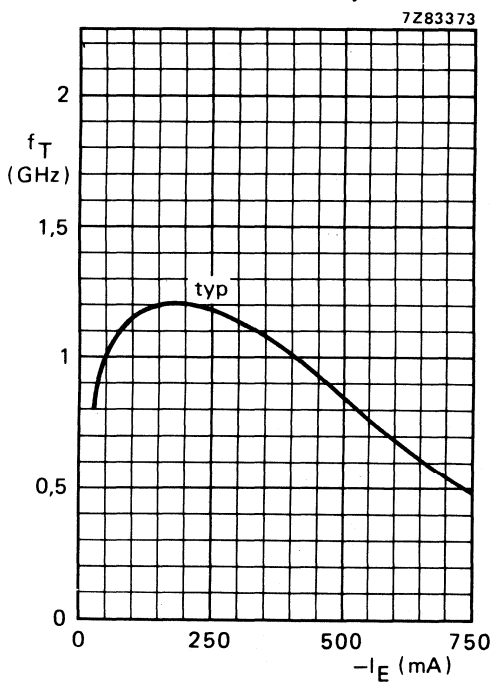


Fig. 6  $V_{CB} = 28\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Z}_L$ ( $\Omega$ )
470	28	2	< 0,13 >	12	< 0,145 >	50	3,0 - j0,4	12 + j45
470	28	2	typ. 0,09	typ. 13,5	typ. 0,135	typ. 53	-	-

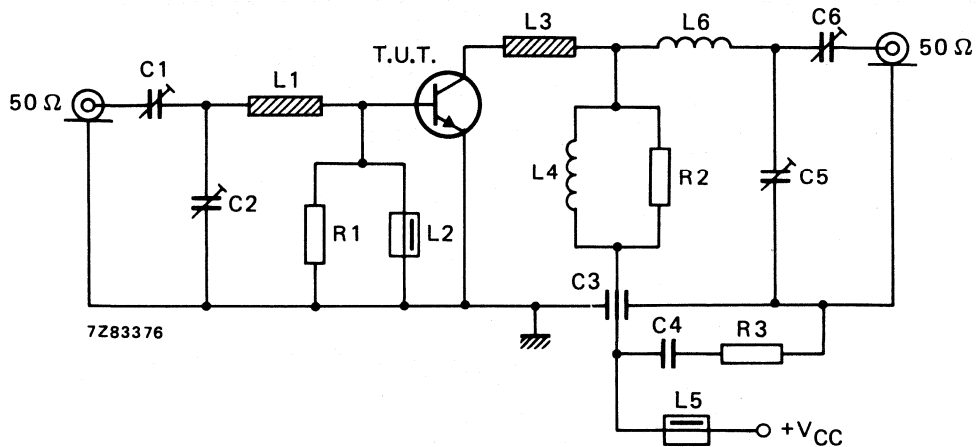


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = C5 = C6 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C2 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C3 = 100 pF ceramic feed-through capacitor

C4 = 100 nF polyester capacitor

L1 = stripline (34,8 mm x 6,0 mm)

L2 = L5 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

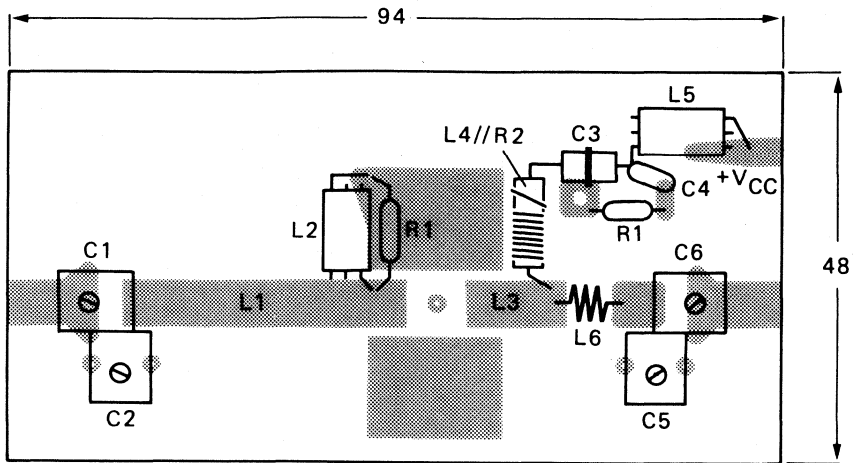
L3 = stripline (12,0 mm x 6,0 mm)

L4 = 220 nH; 10 turns enamelled Cu wire (0,35 mm) closely wound around R2

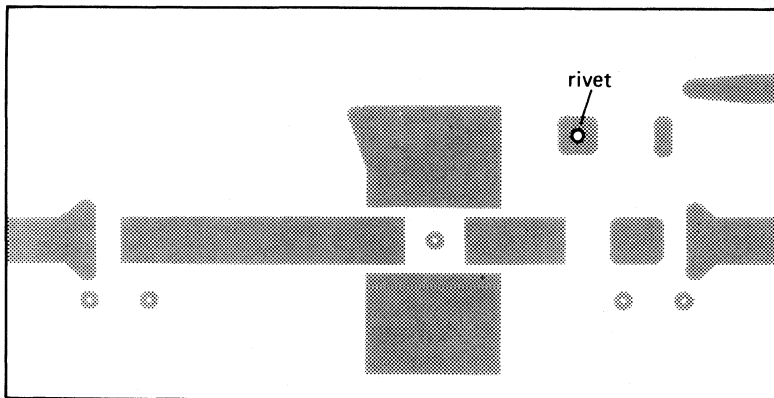
L6 = 29 nH; 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 3,5 mm; leads 2 x 4 mm

L1 and L3 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16".R1 = 100  $\Omega$  carbon resistorR2 = 10 k $\Omega$  carbon resistor (style CR37)R3 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 470 MHz test circuit are shown in Fig. 8.



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Fig. 8 Component layout and printed-circuit board for 470 MHz test circuit.

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

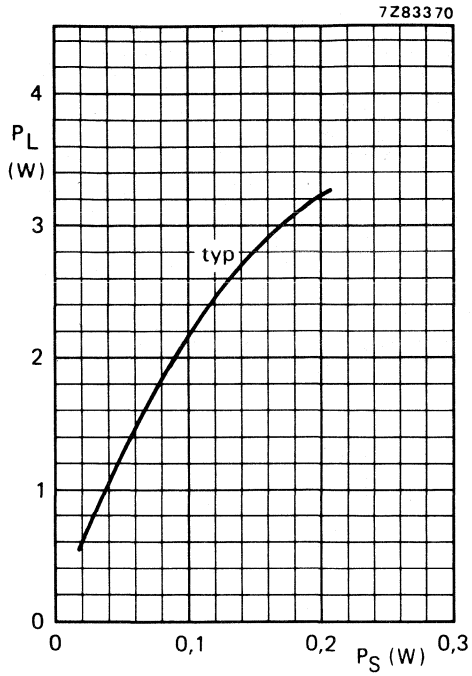


Fig. 9  $V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 25$  °C.

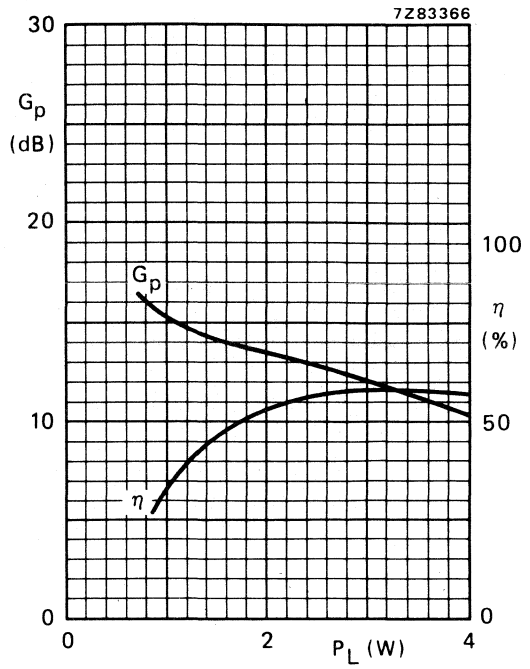


Fig. 10 Typical values;  $V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 25$  °C.

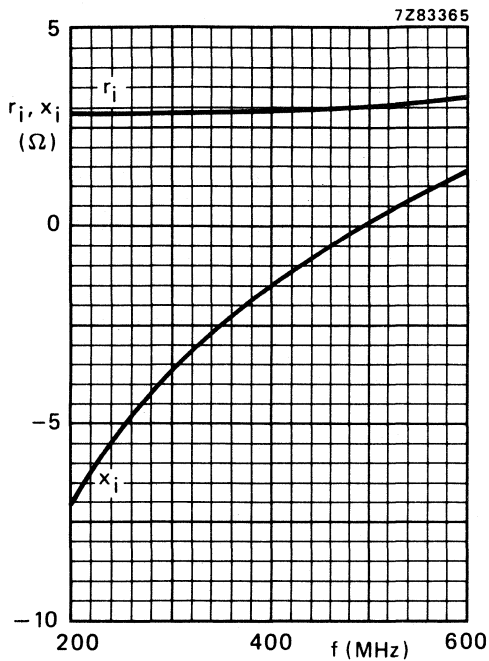


Fig. 11 Input impedance (series components).

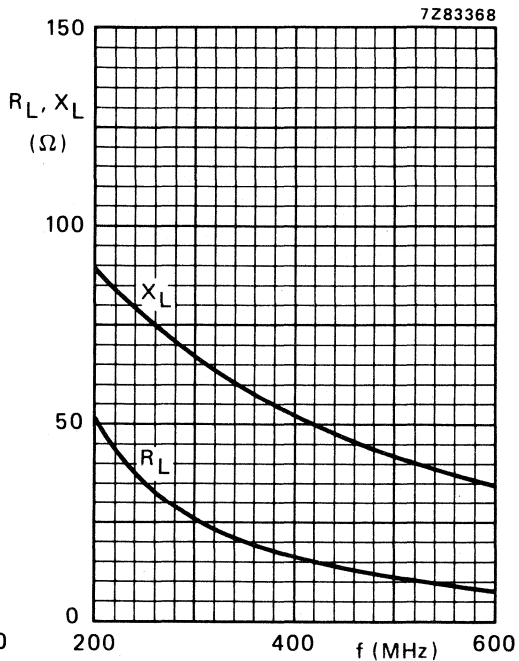


Fig. 12 Load impedance (series components).

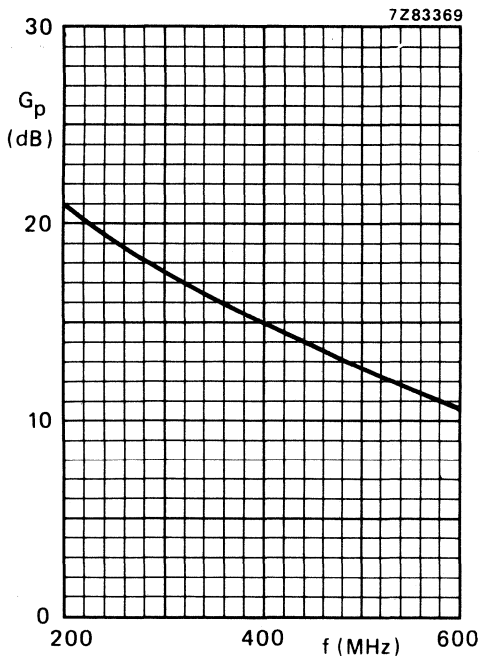


Fig. 13.

Conditions for Figs 11, 12 and 13:

Typical values;  $V_{CE} = 28$  V;  $P_L = 2$  W;

$T_h = 25$  °C.

**Ruggedness**

The BLW89 is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 2 W under the following conditions:

$V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 70$  °C;

$R_{th\ mb-h} = 0,6$  K/W.

## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor suitable for transmitting applications in class-A, B or C in the u.h.f. and v.h.f. range for a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand infinite VSWR at rated output power. High reliability is ensured by a **gold sandwich metallization**.

The transistor is housed in a ¼" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

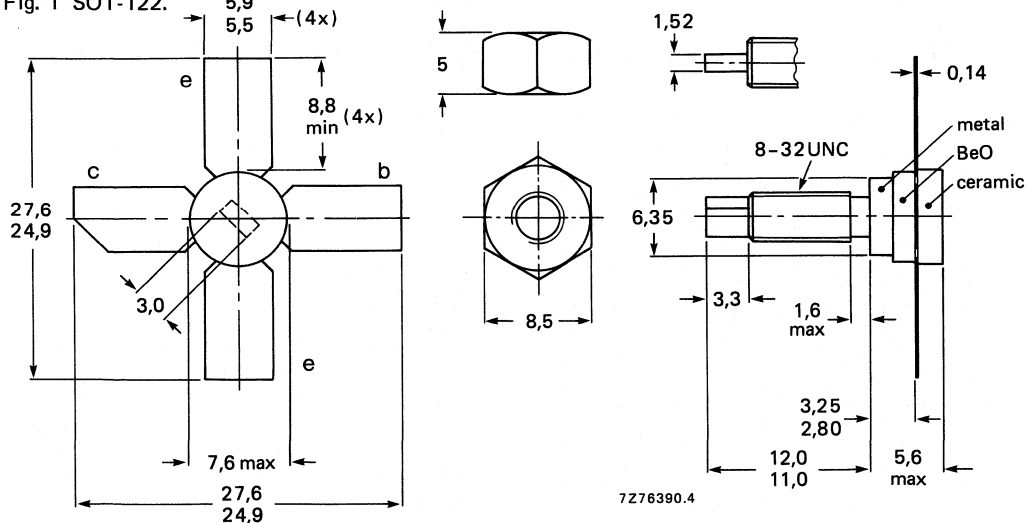
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %
c.w.	28	470	4	> 11	> 55

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak value); $V_{BE} = 0$ open base	$V_{CESM}$	max.	60 V
Emitter-base voltage (open collector)	$V_{CEO}$	max.	30 V
Collector current d.c. or average (peak value); $f > 1$ MHz	$I_C; I_C(AV)$	max.	0,62 A
Total power dissipation (d.c. and r.f.) up to $T_{mb} = 25$ °C	$I_{CM}$	max.	2,0 A
Storage temperature	$P_{tot}$	max.	18,6 W
Operating junction temperature	$T_{stg}$	-65 to + 150 °C	
	$T_j$	max.	200 °C

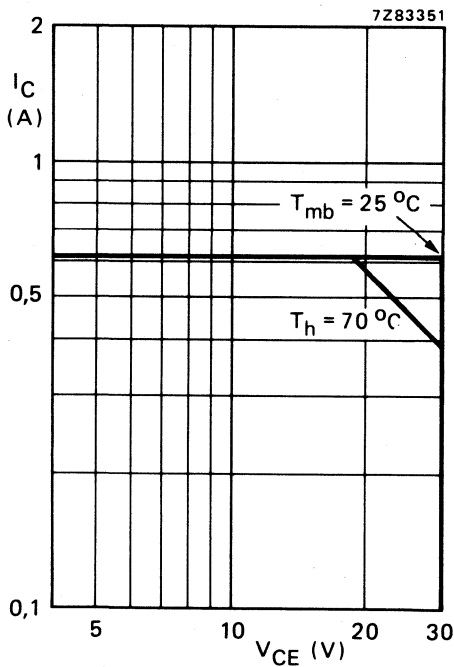


Fig. 2 D.C. SOAR.

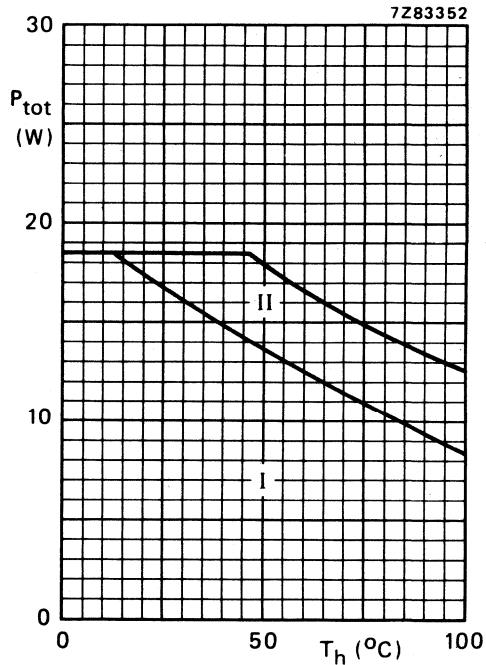


Fig. 3 Power derating curves vs. temperature.  
I Continuous d.c. and r.f. operation  
II Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 6 W;  $T_{mb} = 73,6$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base  
(d.c. and r.f. dissipation)

$R_{th\ j-mb} = 9,0$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0,6$  K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 4\text{ mA}$  $V_{(BR)CES} > 60\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 20\text{ mA}$  $V_{(BR)CEO} > 30\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 2\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 30\text{ V}$  $I_{CES} < 2\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\ \Omega$  $E_{SBO} > 1\text{ mJ}$  $E_{SBR} > 1\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,3\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 1,0\text{ A}; I_B = 0,2\text{ A}$  $V_{CEsat}$  typ. 0,9 VTransition frequency at  $f = 500\text{ MHz}$  \* $-I_E = 0,3\text{ A}; V_{CB} = 28\text{ V}$  $-I_E = 1,0\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 1,2 GHz $f_T$  typ. 0,9 GHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_c$  typ. 8,4 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 20\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re}$  typ. 3,6 pF

Collector-stud capacitance

 $C_{cs}$  typ. 1,2 pF\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}; \delta \leq 0,02$ .

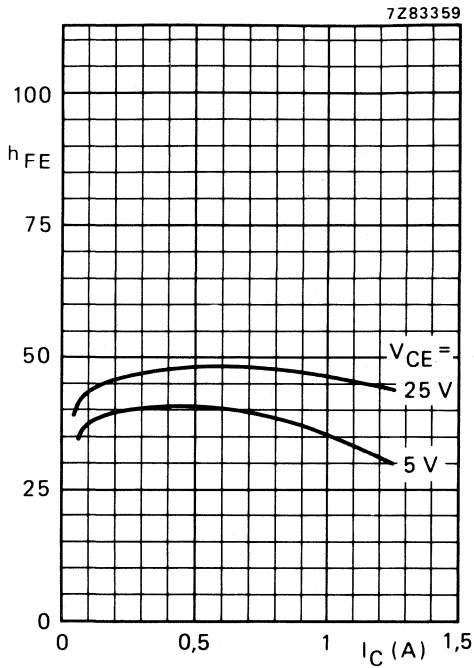


Fig. 4 Typical values;  $T_j = 25^\circ C$ .

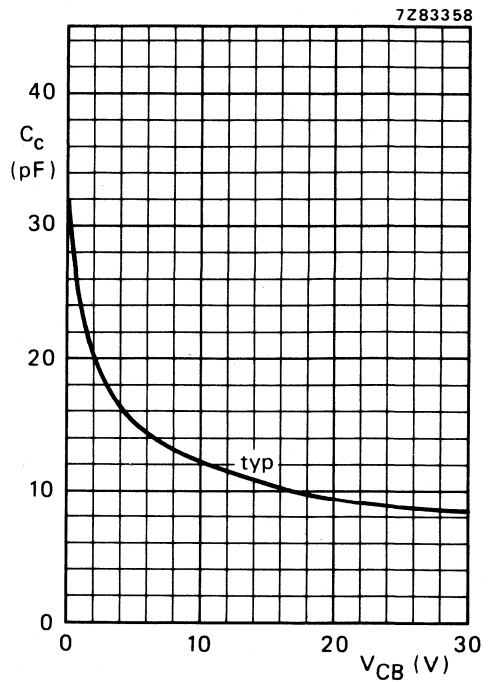


Fig. 5  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25^\circ C$ .

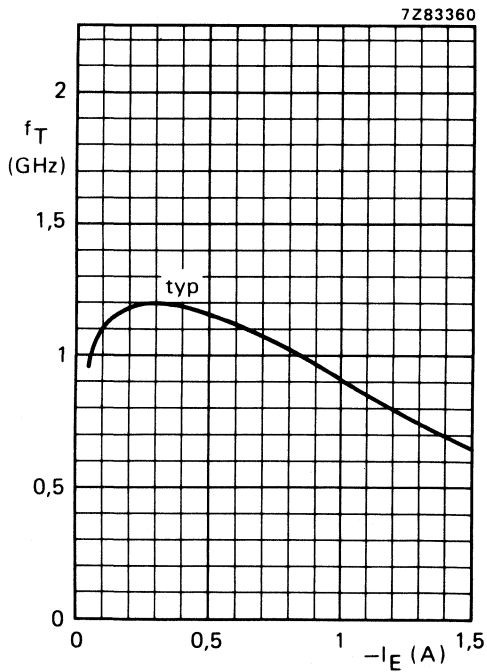


Fig. 6  $V_{CB} = 28$  V;  $f = 500$  MHz;  $T_j = 25^\circ C$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{z}_L$ ( $\Omega$ )
470	28	4	< 0,32	> 11	< 0,26	> 55	$1,7 + j1,8$	$8 + j26$
470	28	4	typ. 0,23	typ. 12,5	typ. 0,25	typ. 58	—	—

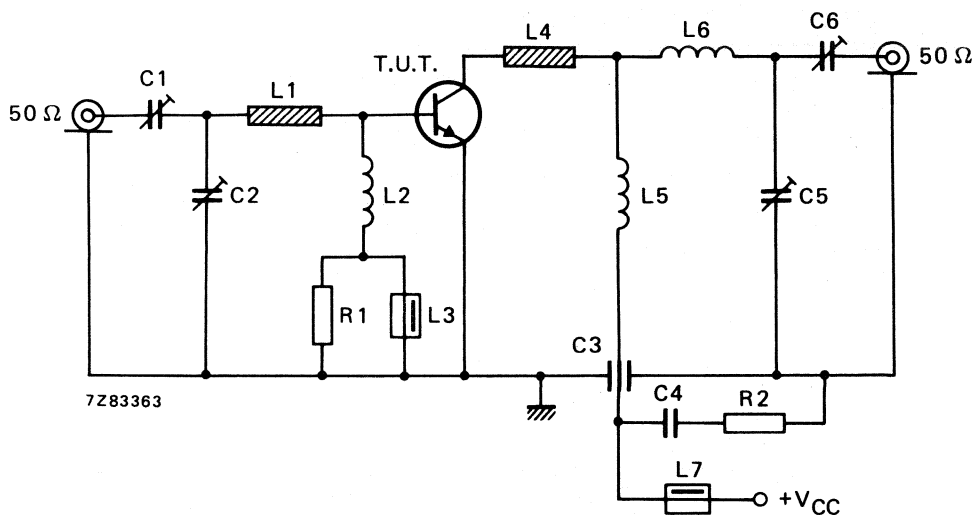


Fig. 7 Test circuit; c.w. class-B.

List of components:

C1 = C5 = C6 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C2 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C3 = 100 pF feed-through capacitor

C4 = 100 nF polyester capacitor

L1 = stripline (34,8 mm x 6,0 mm)

L2 = 320 nH; 13 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 4 mm; leads 2 x 4 mm

L3 = L7 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

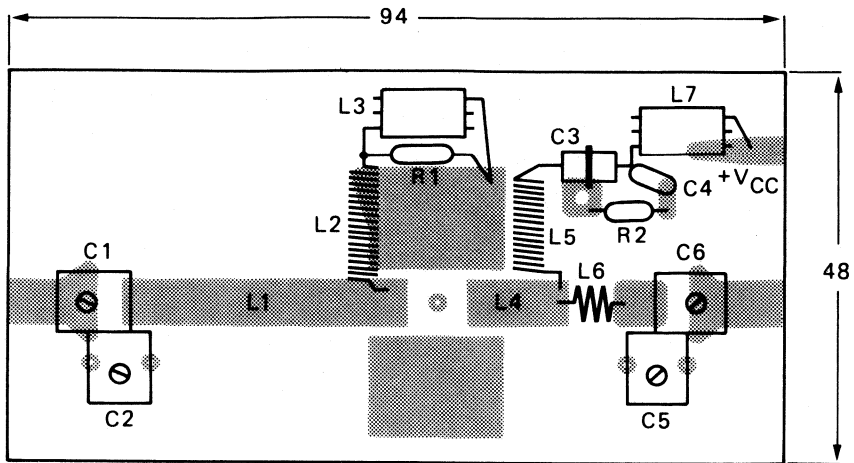
L4 = stripline (12,0 mm x 6,0 mm)

L5 = 265 nH; 13 turns closely wound enamelled Cu wire (0,35 mm); int. dia. 3,5 mm; leads 2 x 4 mm

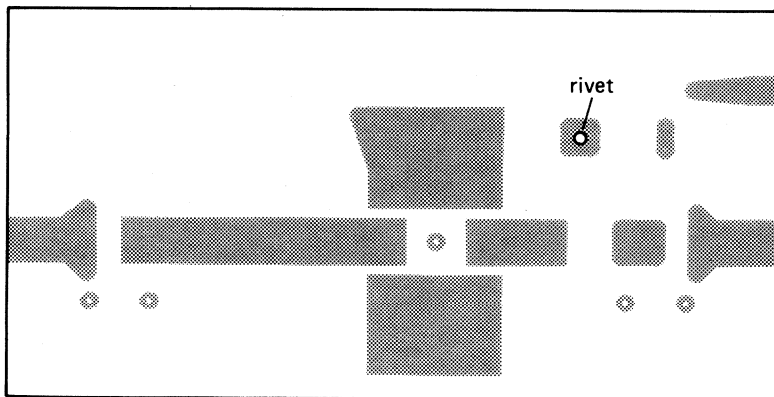
L6 = 29 nH; 3 turns closely wound enamelled Cu wire (1 mm); int. dia. 3,5 mm; leads 2 x 4 mm

L1 and L4 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16".R1 = 100  $\Omega$  carbon resistorR2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 470 MHz test circuit are shown in Fig. 8.



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Fig. 8 Component layout and printed-circuit board for 470 MHz test circuit.

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

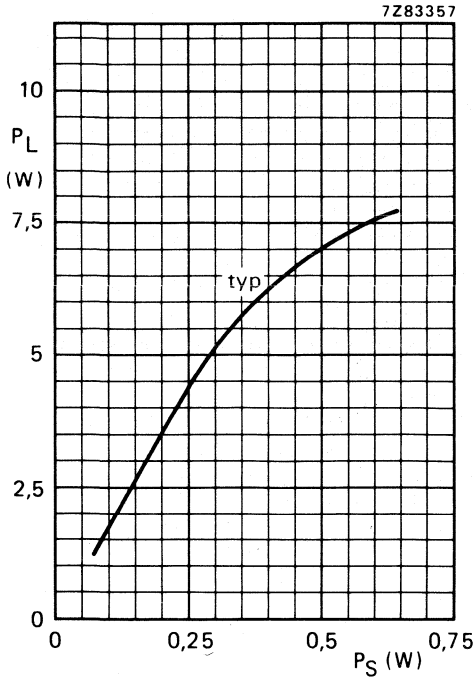


Fig. 9  $V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 25$  °C.

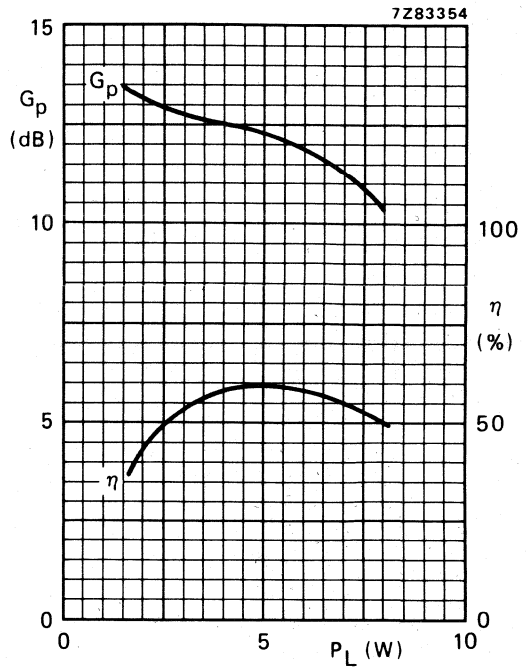


Fig. 10 Typical values;  $V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 25$  °C.

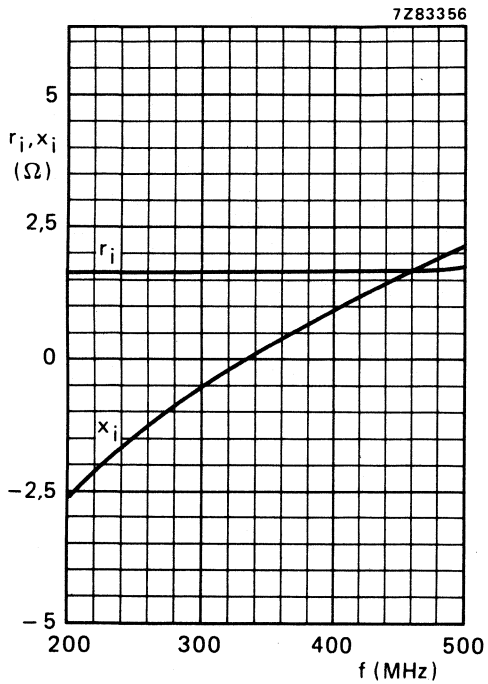


Fig. 11 Input impedance (series components).

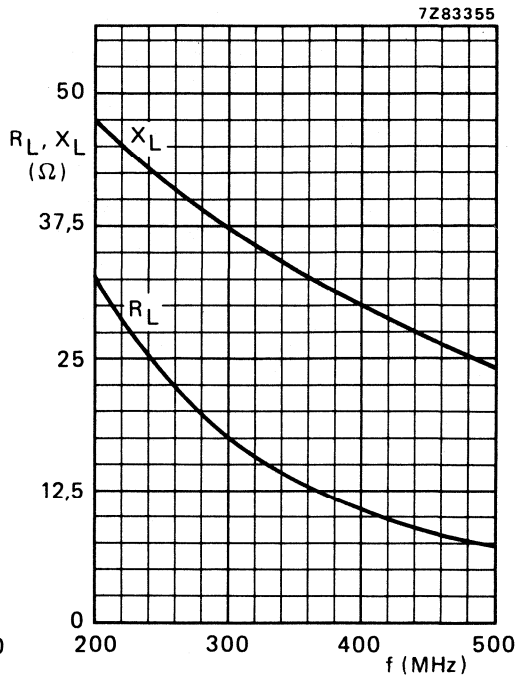


Fig. 12 Load impedance (series components).

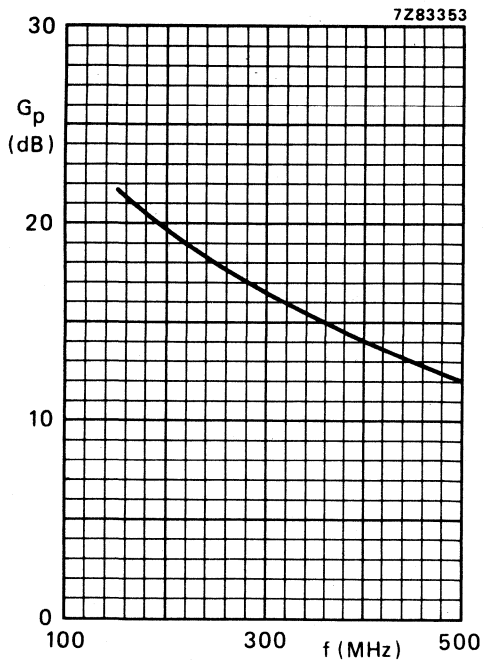


Fig. 13.

Conditions for Figs 11, 12 and 13:

Typical values;  $V_{CE} = 28 \text{ V}$ ;  $P_L = 4 \text{ W}$ ;

$T_h = 25 \text{ }^\circ\text{C}$ .

**Ruggedness**

The BLW90 is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 4 W under the following conditions:

$V_{CE} = 28 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;

$R_{th \text{ mb-h}} = 0,6 \text{ K/W}$ .

## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor suitable for transmitting applications in class-A, B or C in the u.h.f. and v.h.f. range for a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand infinite VSWR at rated output power. High reliability is ensured by a **gold sandwich metallization**.

The transistor is housed in a ¼" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

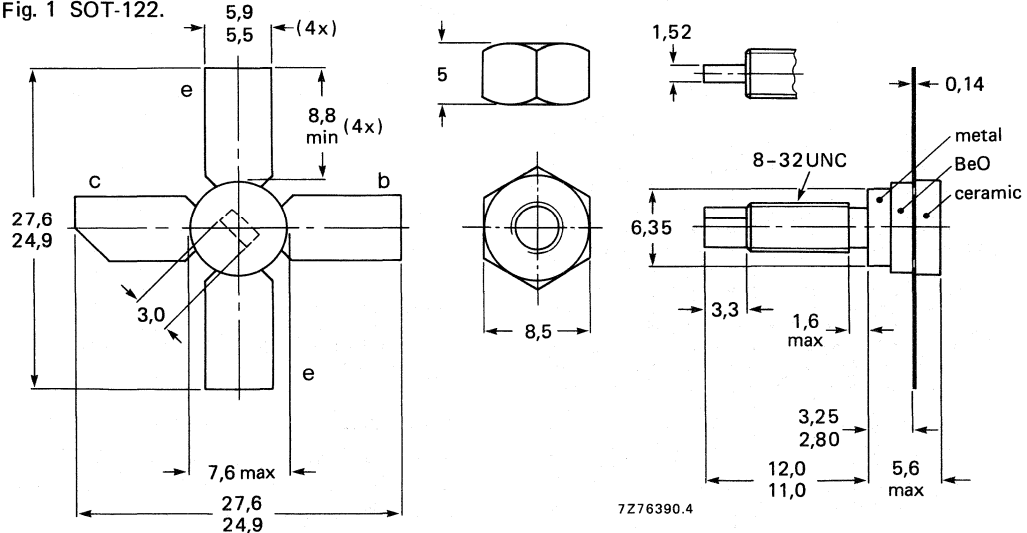
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %
c.w.	28	470	10	>9	>60

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or  
countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage

(peak value);  $V_{BE} = 0$

open base

$V_{CESM}$  max. 60 V

$V_{CEO}$  max. 30 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current

d.c. or average

$I_C; I_{C(AV)}$  max. 1,5 A

(peak value);  $f > 1$  MHz

$I_{CM}$  max. 3,5 A

Total power dissipation up to  $T_{mb} = 35$  °C

$P_{tot}$  max. 30 W

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 32,5 W

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

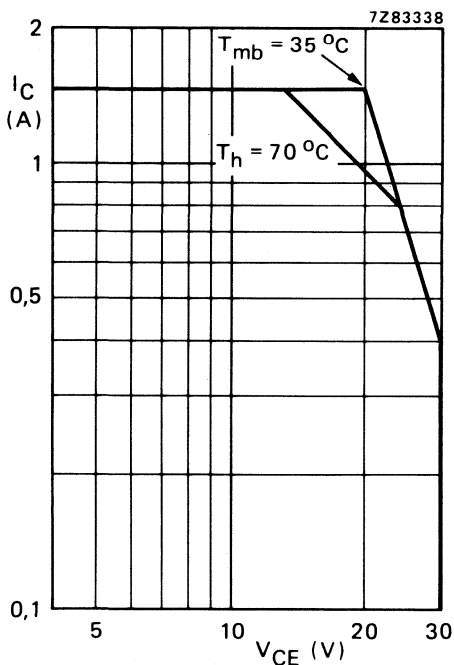


Fig. 2 D.C. SOAR.

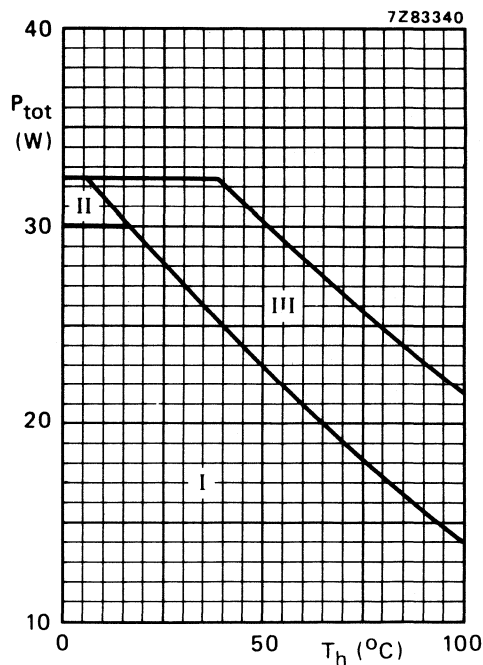


Fig. 3 Power derating curves vs. temperature.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 10 W;  $T_{mb} = 76$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. and r.f. dissipation)

$R_{th\ j-mb} = 6,2$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0,6$  K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 60\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 30\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 4\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 30\text{ V}$  $I_{CES} < 4\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\text{ }\Omega$  $E_{SBO} > 2\text{ mJ}$  $E_{SBR} > 2\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,6\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 2,0\text{ A}; I_B = 0,4\text{ A}$  $V_{CEsat}$  typ. 1,0 VTransition frequency at  $f = 500\text{ MHz}$  \* $-I_E = 0,6\text{ A}; V_{CB} = 28\text{ V}$  $-I_E = 2,0\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 1,2 GHz $f_T$  typ. 1,0 GHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_c$  typ. 17 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 20\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re}$  typ. 8,5 pF

Collector-stud capacitance

 $C_{cs}$  typ. 1,2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

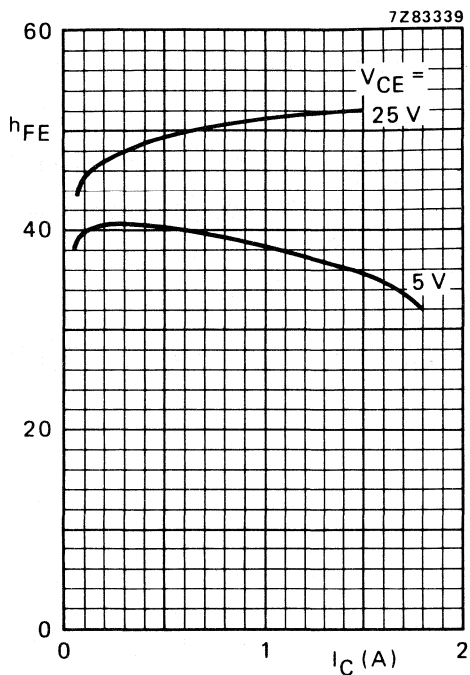


Fig. 4 Typical values;  $T_j = 25^\circ\text{C}$ .

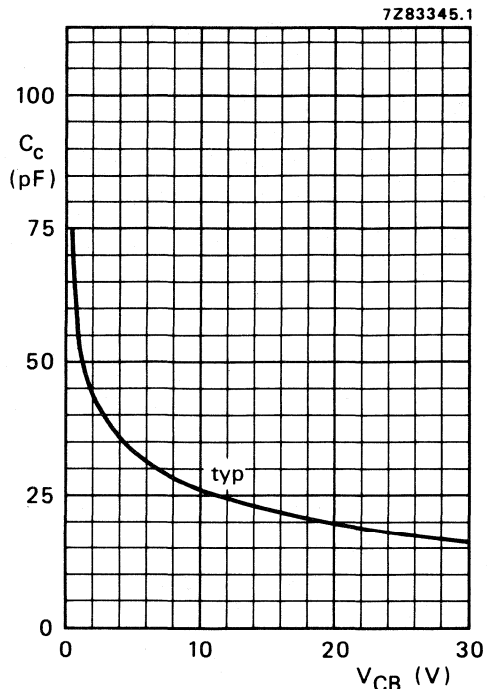


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

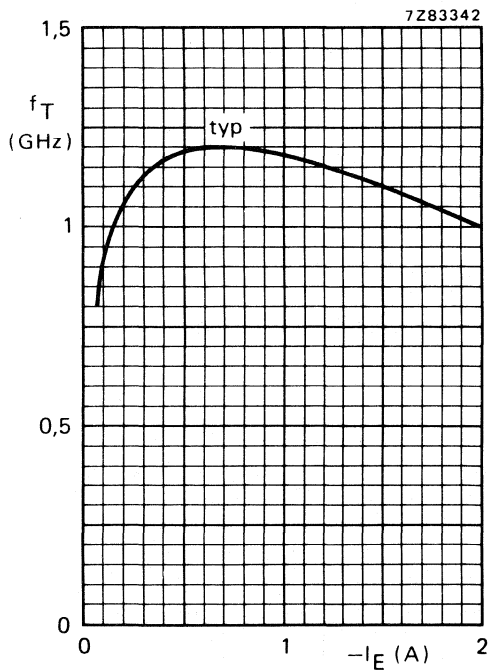


Fig. 6  $V_{CB} = 28\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Z}_L$ ( $\Omega$ )
470	28	10	< 1,26 >	9	< 0,6 >	60	$1,0 + j2,1$	$4,9 + j11$
470	28	10	typ. 0,9	typ. 10,5	typ. 0,56	typ. 63	—	—

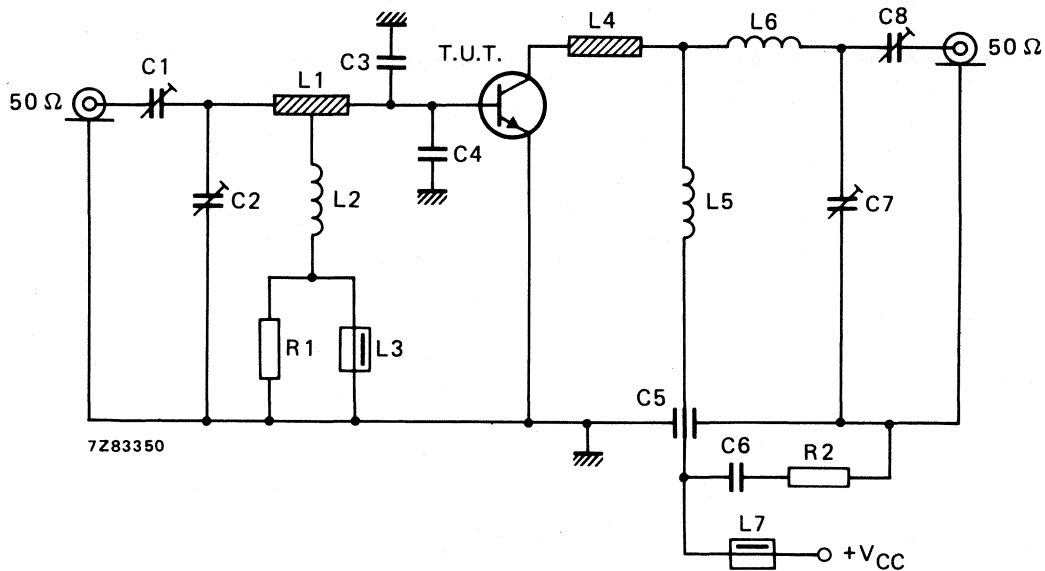


Fig. 7 Test circuit; c.w. class-B. For component layout and p.c.b. see Fig. 8.

## List of components:

C1 = C7 = C8 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)

C2 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C3 = C4 = 15 pF multilayer ceramic chip capacitor (cat. no. 2222 851 13159), middle of capacitor 3 mm from transistor edge

C5 = 100 pF feed-through capacitor

C6 = 100 nF polyester capacitor

L1 = stripline (30,4 mm x 6,0 mm); tap for L2 placed 11 mm from transistor edge

L2 = 320 nH; 13 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 4 mm; leads 2 x 4 mm

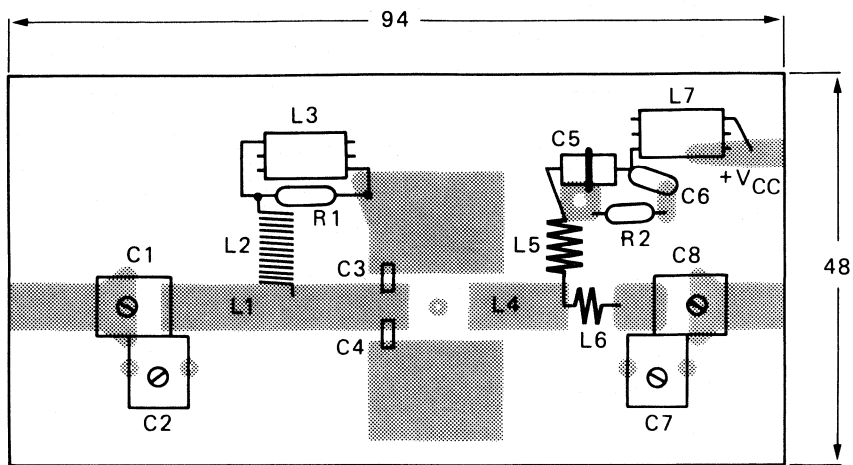
L3 = L7 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = stripline (12,0 mm x 6,0 mm)

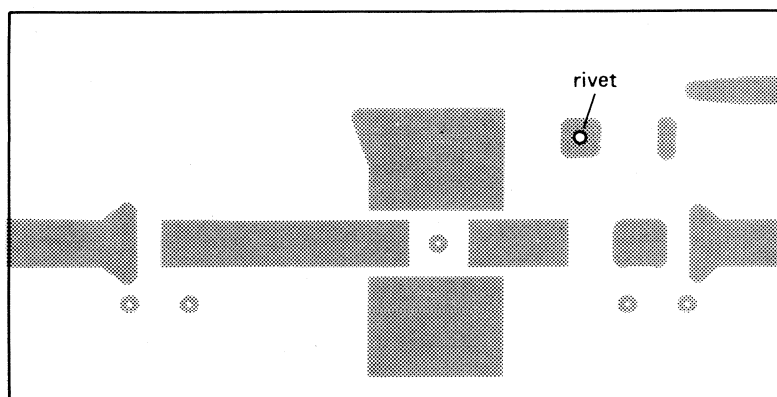
L5 = 78 nH; 5 turns enamelled Cu wire (1,0 mm); int. dia. 5 mm; length 9,3 mm; leads 2 x 5 mm

L6 = 22 nH; 2 turns enamelled Cu wire (1,0 mm); int. dia. 4 mm; length 3,2 mm; leads 2 x 5 mm

L1 and L4 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1/16".R1 = R2 = 10  $\Omega$  carbon resistor



7Z83348



7Z83349

Fig. 8 Component layout and printed-circuit board for 470 MHz test circuit.

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

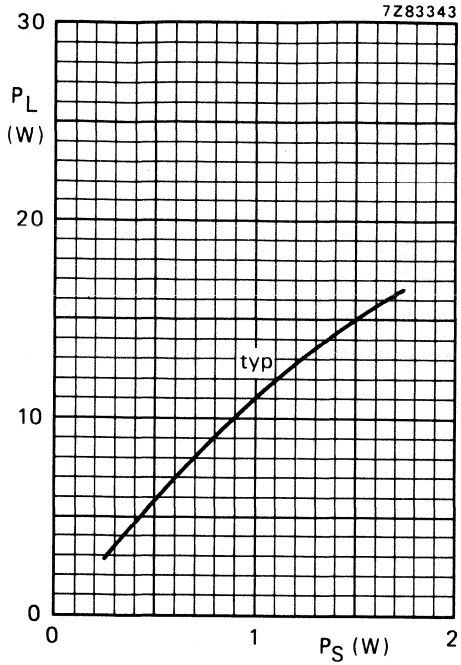


Fig. 9  $V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 25$  °C.

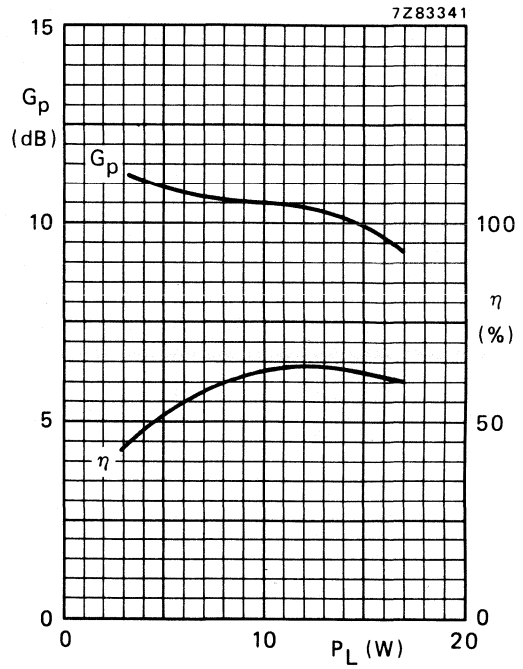


Fig. 10 Typical values;  $V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 25$  °C.

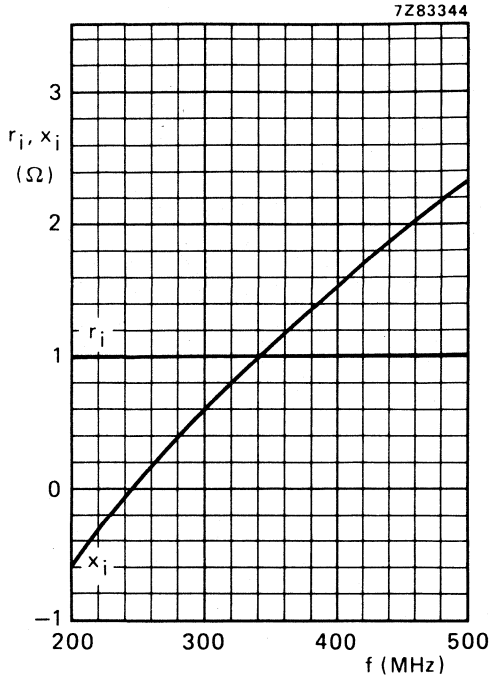


Fig. 11 Input impedance (series components).

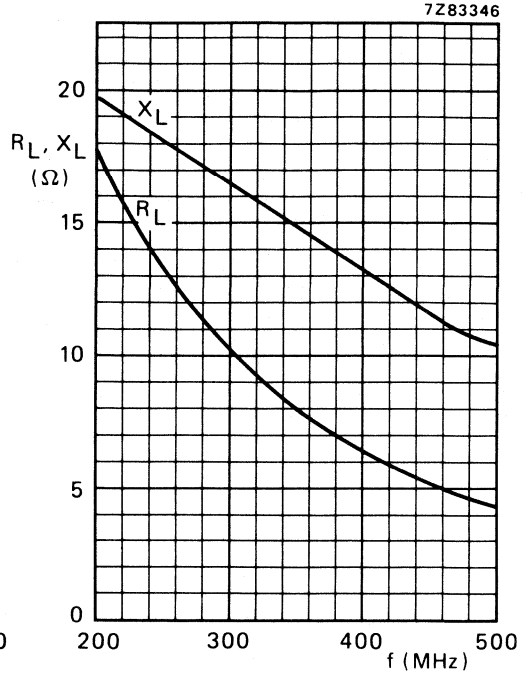
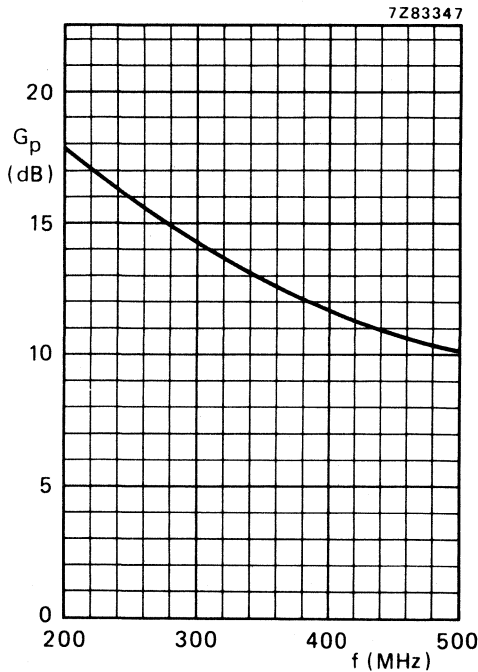


Fig. 12 Load impedance (series components).



Conditions for Figs 11, 12 and 13:

Typical values;  $V_{CE} = 28 \text{ V}$ ;  $P_L = 10 \text{ W}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ .

**Ruggedness**

The BLW91 is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 10 W under the following conditions:

$V_{CE} = 28 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  
 $R_{th \text{ mb-h}} = 0,6 \text{ K/W}$ .

## H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-AB operated high power industrial and military transmitting equipment in the h.f. band. The transistor presents excellent performance as a linear amplifier in s.s.b. applications. It is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Matched  $h_{FE}$  groups are available on request.

The transistor has a  $\frac{1}{2}$ " flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	$I_C(ZS)$ A	f MHz	$P_L$ W	$G_p$ dB	$\eta_{dt}$ %	$d_3$ dB
s.s.b. (class-AB)	50	0,1	1,6 – 28	20 – 160 (P.E.P.)	> 14	> 40*	< -30

\* At 160 W P.E.P.

### MECHANICAL DATA

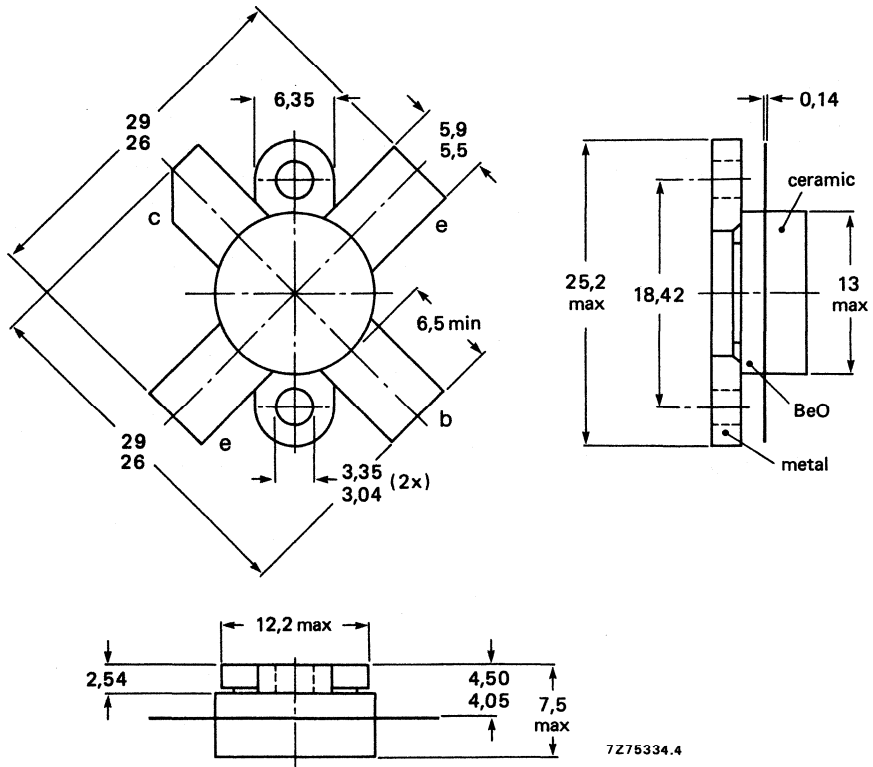
SOT-121A (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

## MECHANICAL DATA

Fig. 1 SOT-121.

Dimensions in mm



Torque on screw: min. 0,6 Nm (6 kg cm)  
 max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.



**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )  
peak value

$V_{CESM}$  max. 110 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 53 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_{C(AV)}$  max. 8 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 20 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 245 W

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

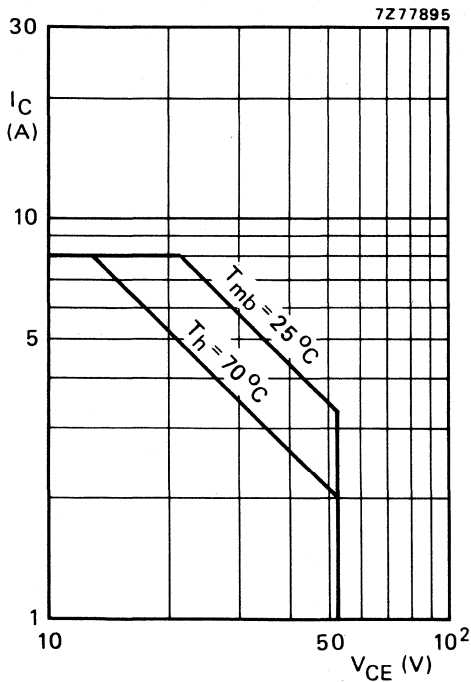


Fig. 2 D.C. SOAR.

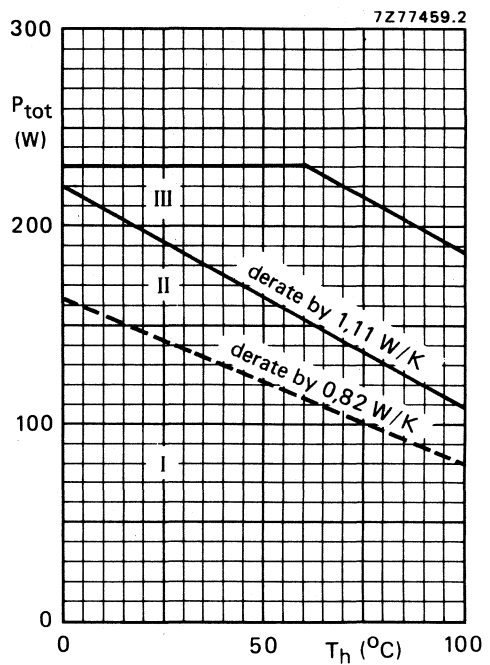


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 50$  V;  $f \geq 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 100 W;  $T_{mb} = 90$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th\ j-mb(dc)}$  = 1,0 K/W

From junction to mounting base (r.f. dissipation)

$R_{th\ j-mb(rf)}$  = 0,7 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,2 K/W

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 25\text{ mA}$

$V_{(BR)CES} > 110\text{ V}$

Collector-emitter breakdown voltage

open base;  $I_C = 100\text{ mA}$

$V_{(BR)CEO} > 53\text{ V}$

Emitter-base breakdown voltage

open collector;  $I_E = 20\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0; V_{CE} = 53\text{ V}$

$I_{CES} < 10\text{ mA}$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$

open base

$R_{BE} = 10\text{ }\Omega$

$ESBO > 12,5\text{ mJ}$

$ESBR > 12,5\text{ mJ}$

D.C. current gain \*

$I_C = 4\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE}$  typ. 30  
15 to 50

D.C. current gain ratio of matched devices \*

$I_C = 4\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE1}/h_{FE2} \leq 1,2$

Collector-emitter saturation voltage \*

$I_C = 12,5\text{ A}; I_B = 2,5\text{ A}$

$V_{CEsat}$  typ. 2,2 V

Transition frequency at  $f = 100\text{ MHz}$  \*

$-I_E = 4\text{ A}; V_{CB} = 40\text{ V}$

$-I_E = 12,5\text{ A}; V_{CB} = 40\text{ V}$

$f_T$  typ. 270 MHz

$f_T$  typ. 285 MHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 50\text{ V}$

$C_c$  typ. 185 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 150\text{ mA}; V_{CE} = 50\text{ V}$

$C_{re}$  typ. 115 pF

Collector-flange capacitance

$C_{cf}$  typ. 3 pF

\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

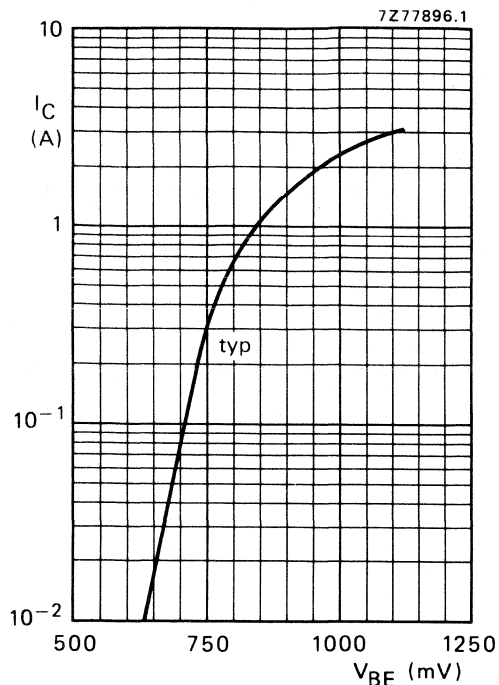


Fig. 4  $V_{CE} = 40$  V;  $T_h = 25$  °C.

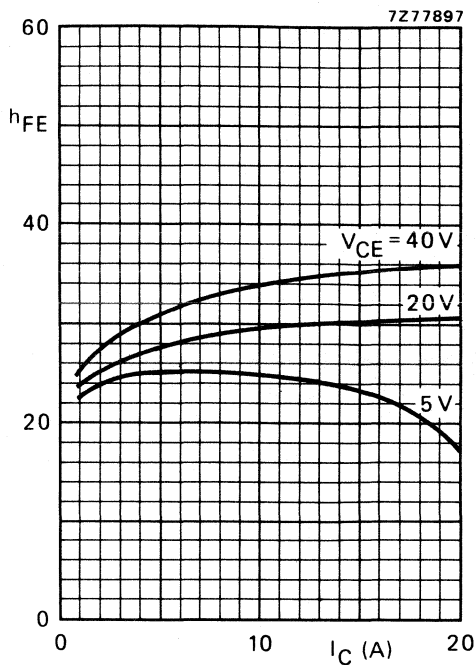


Fig. 5 Typical values;  $T_j = 25$  °C.

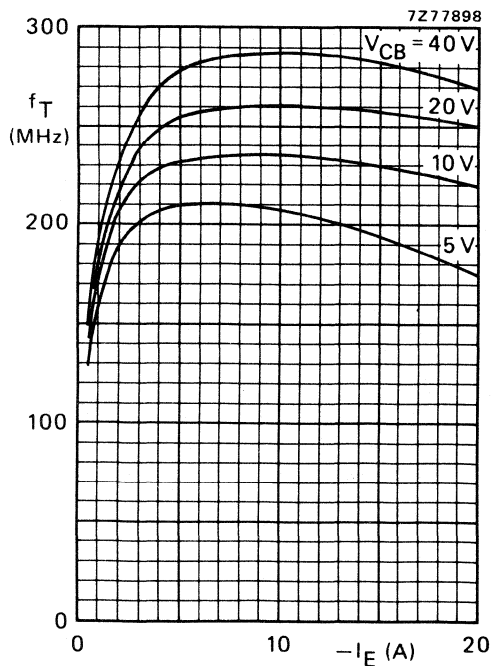


Fig. 6 Typical values;  $f = 100$  MHz;  $T_j = 25$  °C.

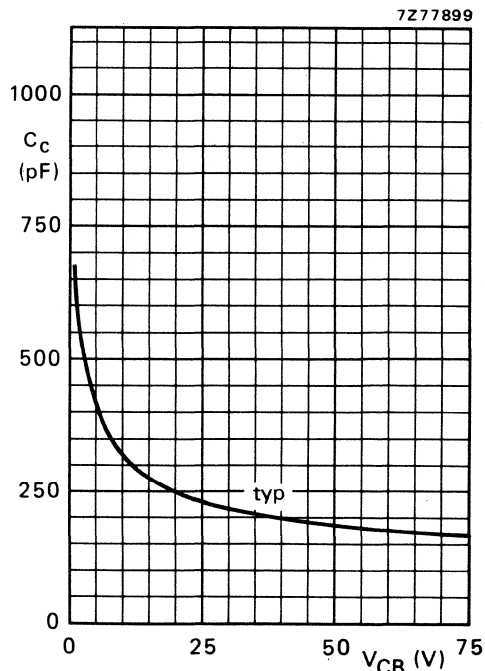


Fig. 7  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25$  °C.

## APPLICATION INFORMATION

R.F. performance in s.s.b. class-AB operation (linear power amplifier)

 $V_{CE} = 50 \text{ V}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$\eta_{dt}$ (%) at 160 W (P.E.P.)	$I_C$ (A) at 160 W (P.E.P.)	$d_3$ dB *	$d_5$ dB *	$I_C(Z_S)$ A
20 to 160 (P.E.P.)	> 14	> 40	< 4,0	< -30	< -30	0,1

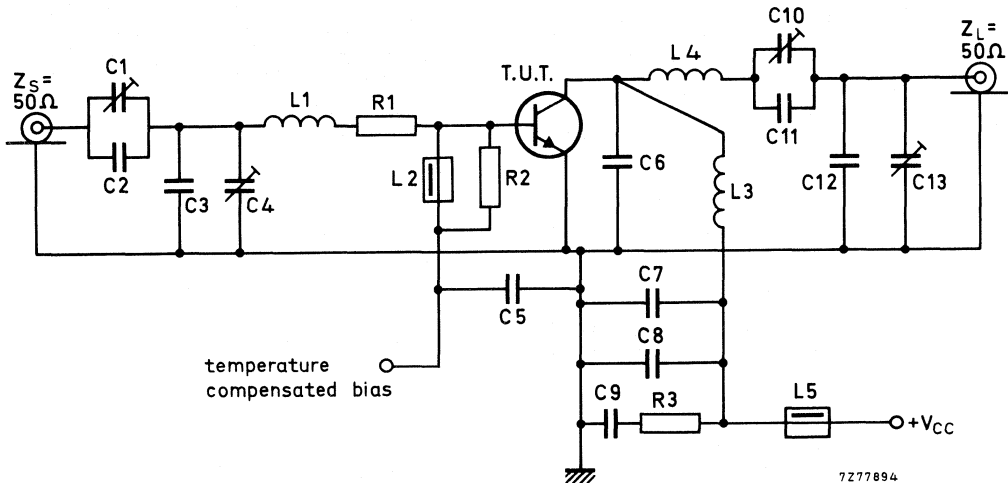


Fig. 8 Test circuit; s.s.b. class-AB.

## List of components:

C1 = C10 = 100 pF film dielectric trimmer

C2 = C6 = 27 pF ceramic capacitor (500 V)

C3 = 220 pF polystyrene capacitor

C4 = C13 = 100 pF film dielectric trimmer

C5 = C7 = 3,9 nF ceramic capacitor

C8 = 100 nF polyester capacitor

C9 = 2,2  $\mu$ F moulded metallized polyester capacitor

C11 = 68 pF ceramic capacitor (500 V)

C12 = 220 pF polystyrene capacitor

L1 = 88 nH; 3 turns Cu wire (1,0 mm); int. dia. 9,0 mm; length 6,1 mm; leads 2 x 5 mm

L2 = L5 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 180 nH; 4 turns enamelled Cu wire (1,6 mm); int. dia. 12,0 mm; length 9,9 mm; leads 2 x 10 mm

L4 = 350 nH; 7 turns enamelled Cu wire (1,6 mm); int. dia. 12,0 mm; length 19,1 mm; leads 2 x 10 mm

R1 = 0,66  $\Omega$ ; parallel connection of 5 x 3,3  $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,5 W each)R2 = 27  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)R3 = 4,7  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

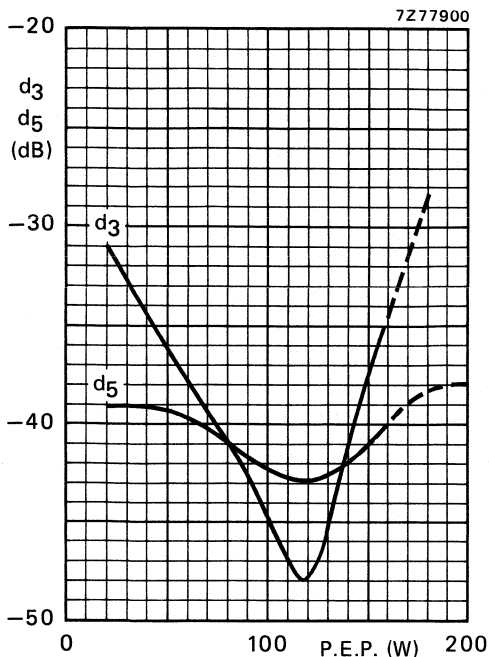


Fig. 9 Intermodulation distortion as a function of output power.\*

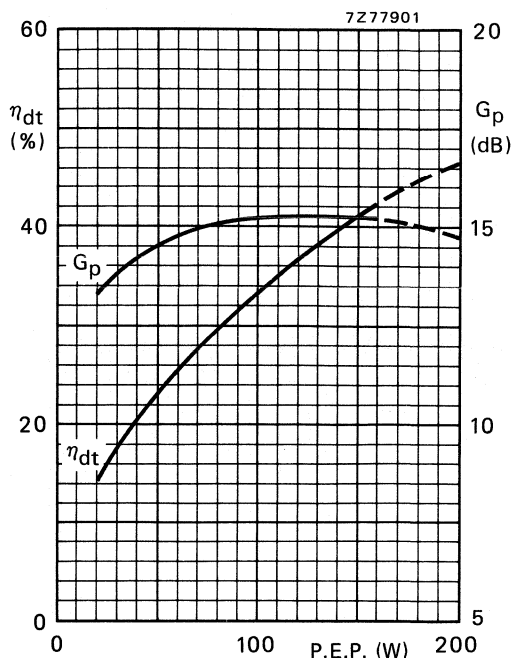


Fig. 10 Double-tone efficiency and power gain as a function of output power.

Conditions for Figs 9 and 10:

$V_{CE} = 50 \text{ V}$ ;  $I_{C(ZS)} = 0,1 \text{ A}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ; typical values.

**Ruggedness**

The BLW95 is capable of withstanding full load mismatch (VSWR = 50) up to 150 W (P.E.P.) under the following conditions:

$V_{CE} = 45\text{V}$ ;  $f = 28 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

\* See note on previous page.

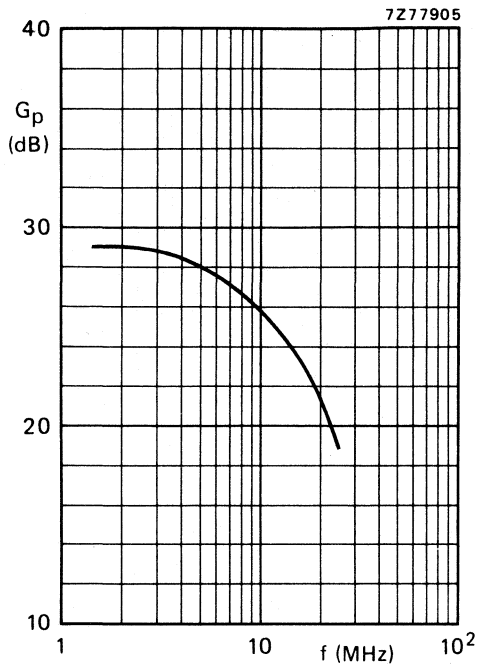


Fig. 11 Power gain as a function of frequency.

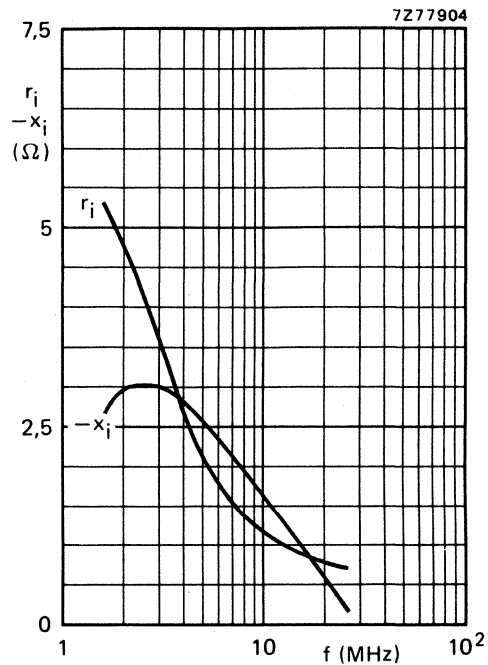


Fig. 12 Input impedance (series components) as a function of frequency.

Figs 11 and 12 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 50 \text{ V}$ ;  $I_{C(ZS)} = 0,1 \text{ A}$ ;  $P_L = 160 \text{ W (P.E.P.)}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 6,25 \text{ } \Omega$  in series with  $7,3 \text{ nH}$  (in parallel with  $-188 \text{ pF}$ ).

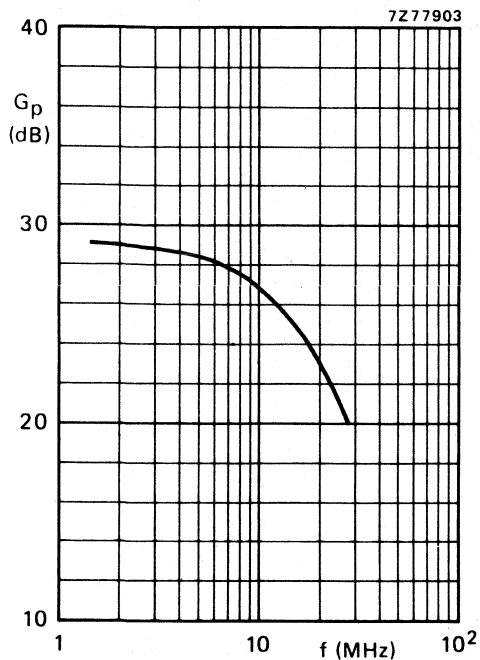


Fig. 13 Power gain as a function of frequency.

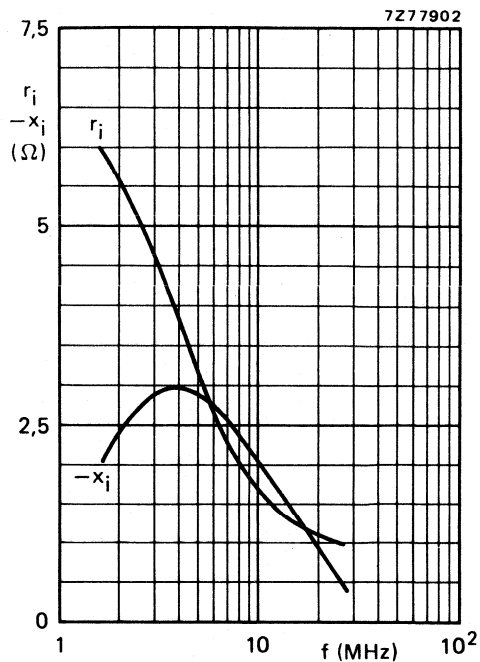


Fig. 14 Input impedance (series components) as a function of frequency.

Figs 13 and 14 are typical curves and hold for one transistor of a push-pull amplifier with cross-neutralization in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 50$  V;  $I_{C(ZS)} = 0,1$  A;  $P_L = 160$  W (P.E.P.);  $T_h = 25$  °C;  $Z_L = 6,25$   $\Omega$  in series with 10,4 nH (in parallel with  $-267$  pF); neutralizing capacitor: 82 pF.





## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, AB and B operated high power industrial and military transmitting equipment in the h.f. and v.h.f. band. The transistor presents excellent performance as a linear amplifier in s.s.b. applications. It is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Transistors are supplied in matched  $h_{FE}$  groups. The transistor has a  $\frac{1}{2}$ " flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$d_3$ dB	$d_5$ dB	$I_C(ZS)$ ( $I_C$ ) A
s.s.b. (class-AB)	50	1,6 – 28	25 – 200 (P.E.P.)	> 13,5	> 40*	< -30	< -30	0,1
c.w. (class-B)	50	108	200	typ. 6,5	typ. 67	—	—	(6)
s.s.b. (class-A)	40	28	50 (P.E.P.)	typ. 19	—	typ. -40	< -40	(4)

\*  $\eta_{dt}$  at 200 W P.E.P.

### MECHANICAL DATA

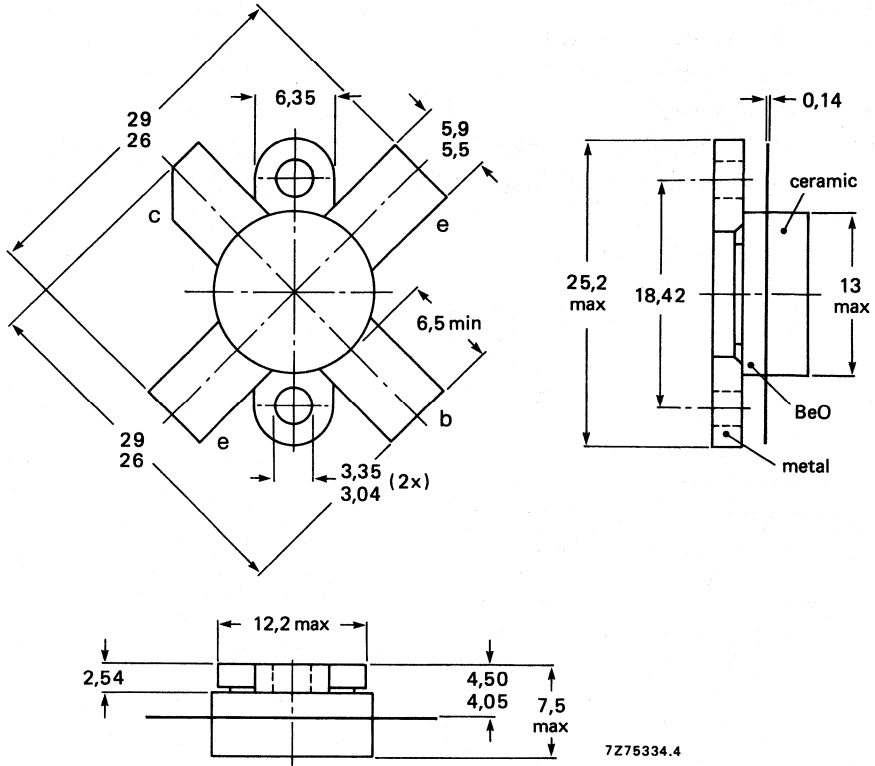
SOT-121 (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-121.

Dimensions in mm



Torque on screw: min. 0,6 Nm (6 kg cm)

max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	110 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	55 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	12 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	40 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 45$ °C	$P_{rf}$	max.	340 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

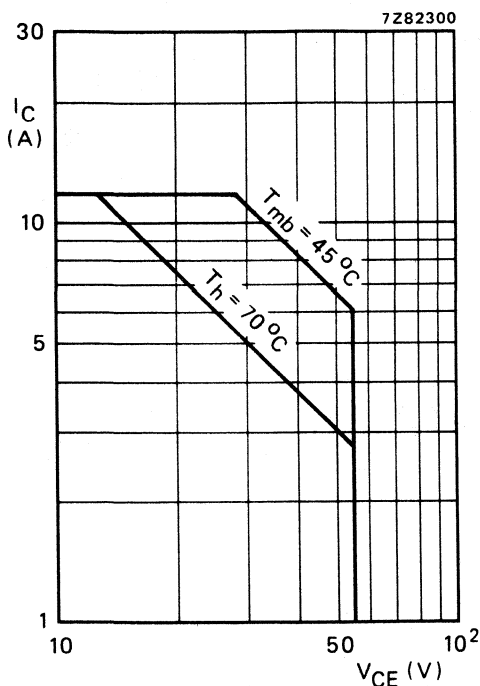


Fig. 2 D.C. SOAR.

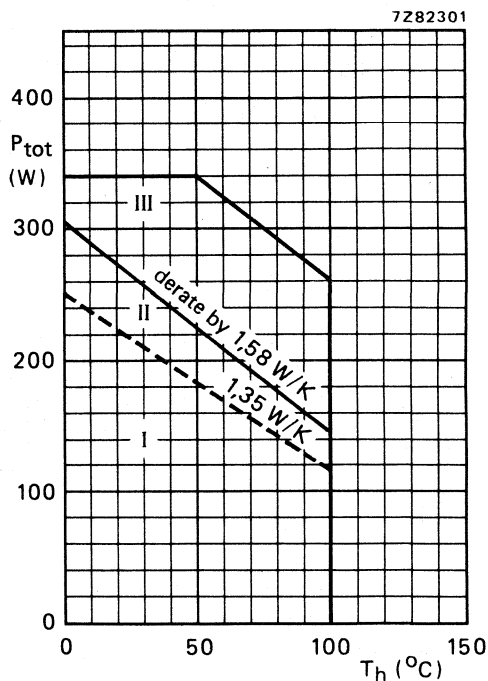


Fig. 3 Power/temperature derating curves.

- I Continuous d.c. operation
- II Continuous r.f. operation;  $f > 1$  MHz
- III Short-time operation during mismatch;  $f > 1$  MHz

**THERMAL RESISTANCE** (dissipation = 150 W;  $T_{mb} = 100$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th j-mb(dc)}$	=	0,63 K/W
From junction to mounting base (r.f. dissipation)	$R_{th j-mb(rf)}$	=	0,45 K/W
From mounting base to heatsink	$R_{th mb-h}$	=	0,2 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 50\text{ mA}$  $V_{(BR)CES} > 110\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 200\text{ mA}$  $V_{(BR)CEO} > 55\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 20\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 55\text{ V}$  $I_{CES} < 10\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $ESBO > 20\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $ESBR > 20\text{ mJ}$ 

D.C. current gain\*

 $I_C = 7\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 30  
15 to 50

D.C. current gain ratio of matched devices\*

 $I_C = 7\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE1}/h_{FE2} \leq 1,2$ 

Collector-emitter saturation voltage\*

 $I_C = 20\text{ A}; I_B = 4\text{ A}$  $V_{CEsat}$  typ. 1,9 VTransition frequency at  $f = 100\text{ MHz}$ \*\* $-I_E = 7\text{ A}; V_{CB} = 45\text{ V}$  $f_T$  typ. 235 MHz $-I_E = 20\text{ A}; V_{CB} = 45\text{ V}$  $f_T$  typ. 245 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 50\text{ V}$  $C_C$  typ. 280 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 150\text{ mA}; V_{CE} = 50\text{ V}$  $C_{re}$  typ. 170 pF

Collector-flange capacitance

 $C_{cf}$  typ. 4,4 pF\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0,02$ .\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}; \delta \leq 0,01$ .

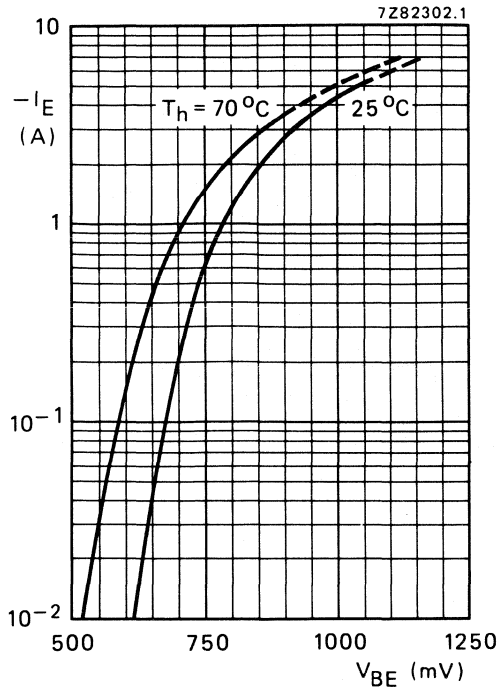


Fig. 4 Typical values;  $V_{CE} = 40\text{ V}$ .

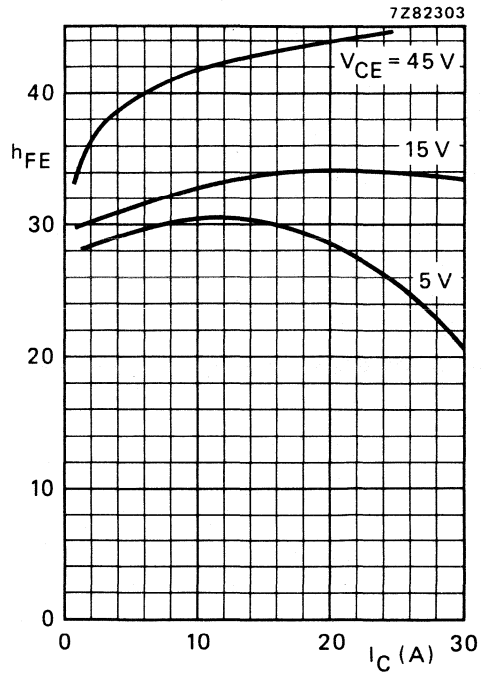


Fig. 5 Typical values;  $T_j = 25^\circ\text{C}$ .

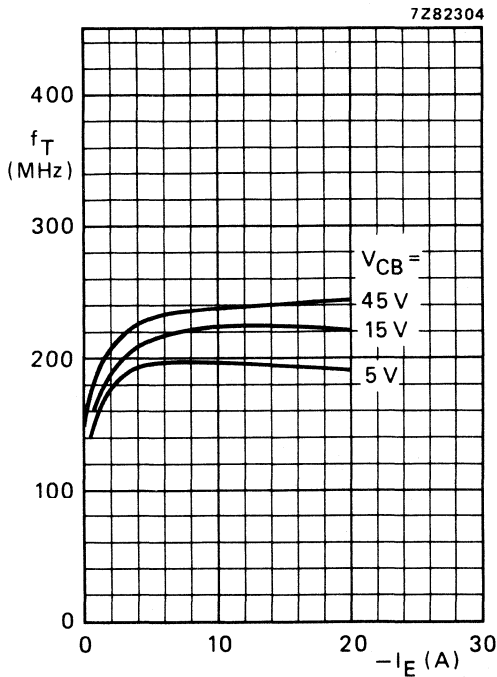


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

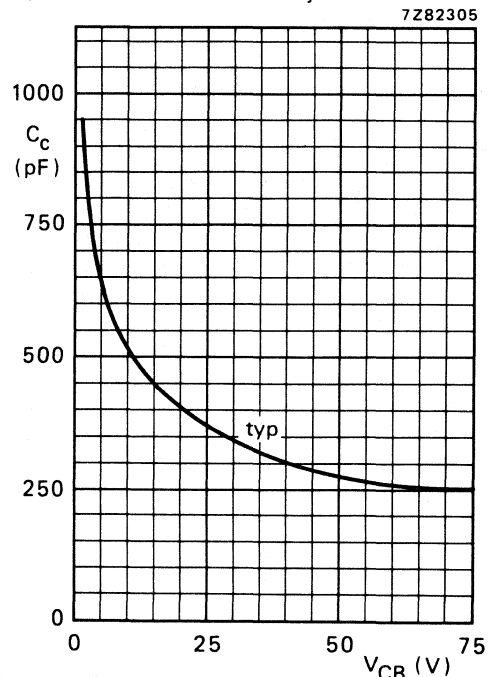


Fig. 7  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in s.s.b. class-AB operation (linear power amplifier)

 $V_{CE} = 50 \text{ V}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$\eta_{dt}(\%)$ at 200 W (P.E.P.)	$I_C$ (A)	$d_3^*$ dB	$d_5^*$ dB	$I_C(ZS)$ A
25 to 200 (P.E.P.)	> 13,5	> 40	< 5,0	< -30	< -30	0,1

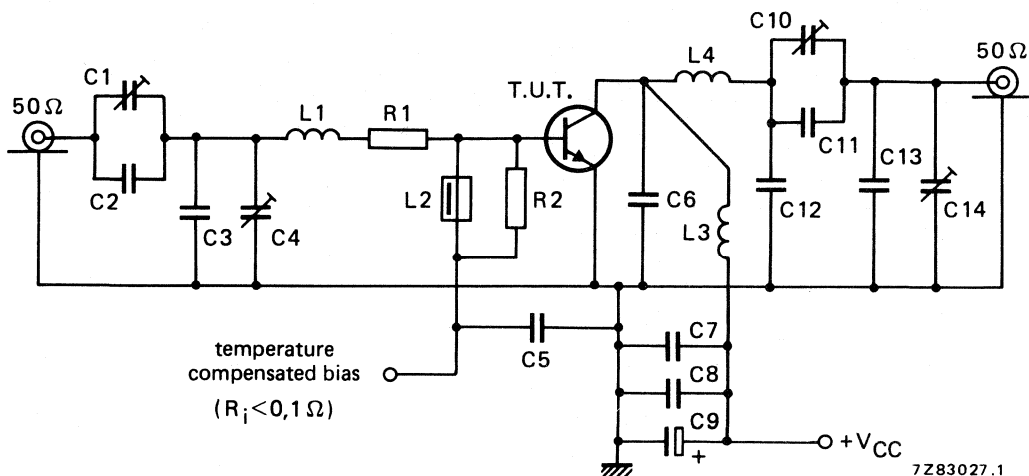


Fig. 8 Test circuit; s.s.b. class-AB.

## List of components:

C1 = C4 = C10 = C14 = 100 pF film dielectric trimmer

C2 = 27 pF ceramic capacitor (500 V)

C3 = 270 pF polysterene capacitor (630 V)

C5 = C7 = C8 = 220 nF multilayer ceramic chip capacitor

C6 = 27 pF multilayer ceramic chip capacitor (500 V; ATC▲)

C9 = 47  $\mu\text{F}$ /63 V electrolytic capacitor

C11 = 2 x 36 pF multilayer ceramic chip capacitors (500 V; ATC▲) in parallel

C12 = 2 x 43 pF multilayer ceramic chip capacitors (500 V; ATC▲) in parallel

C13 = 43 pF multilayer ceramic chip capacitor (500 V; ATC▲)

L1 = 88 nH; 3 turns Cu wire (1,0 mm); int. dia. 9,0 mm; length 6,1 mm; leads 2 x 5 mm

L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 150 nH; 5 turns Cu wire (2,0 mm); int. dia. 10,0 mm; length 18,7 mm; leads 2 x 5 mm

L4 = 197 nH; 5 turns Cu wire (2,0 mm); int. dia. 12,0 mm; length 18,6 mm; leads 2 x 5 mm

R1 = 0,66  $\Omega$ ; parallel connection of 5 x 3,3  $\Omega$  metal film resistors (PR37;  $\pm 5\%$ ; 1,6 W each)R2 = 27  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

▲ ATC means American Technical Ceramics.

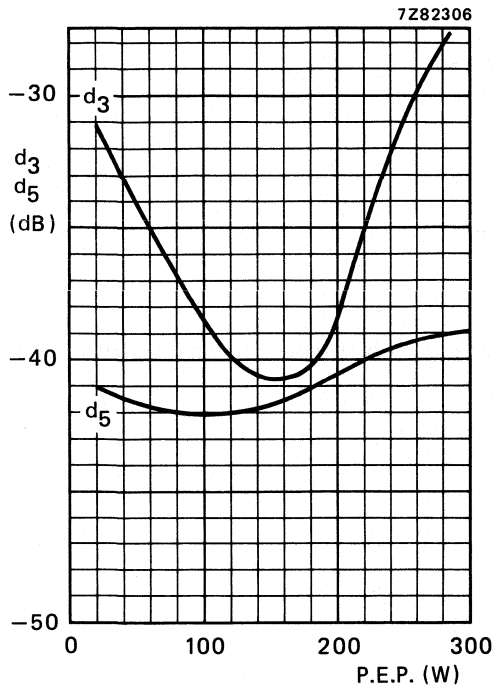


Fig. 9 Intermodulation distortion as a function of output power.\*

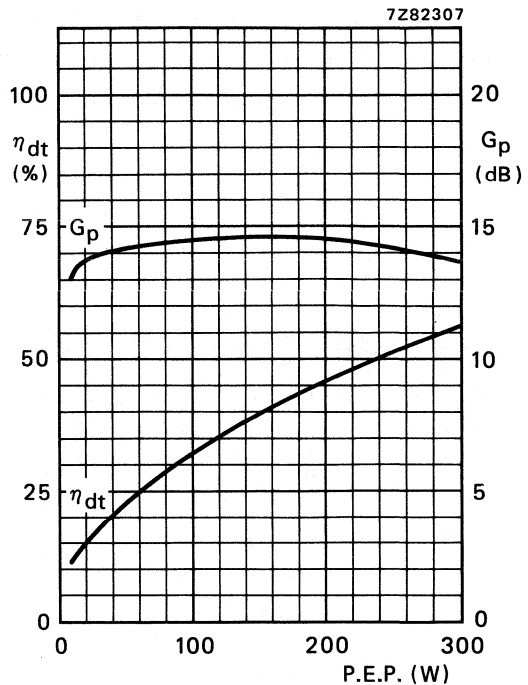


Fig. 10 Double-tone efficiency and power gain as a function of output power.

Conditions for Figs 9 and 10:

$V_{CE} = 50$  V;  $I_C(ZS) = 0,1$  A;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  $T_h = 25$  °C; typical values.

#### Ruggedness

The BLW96 is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 150 W (P.E.P.) or a load mismatch (VSWR = 5 through all phases) up to 200 W (P.E.P.) under the following conditions:

$V_{CE} = 45$  V;  $f = 28$  MHz;  $T_h = 70$  °C;  $R_{th\ mb-h} = 0,2$  K/W.

\* See note on previous page.

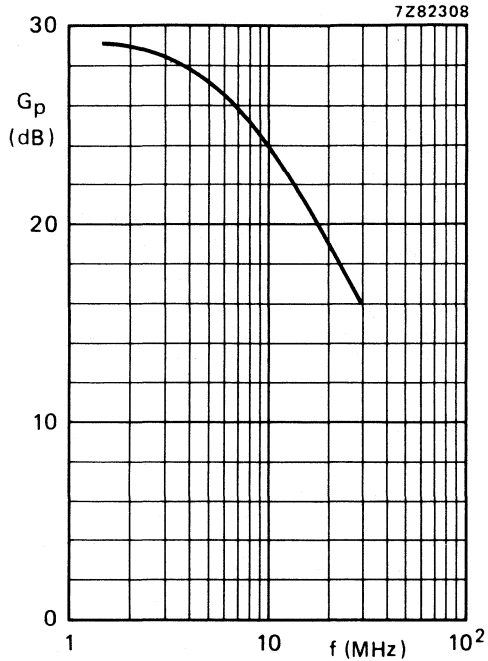


Fig. 11 Power gain as a function of frequency.

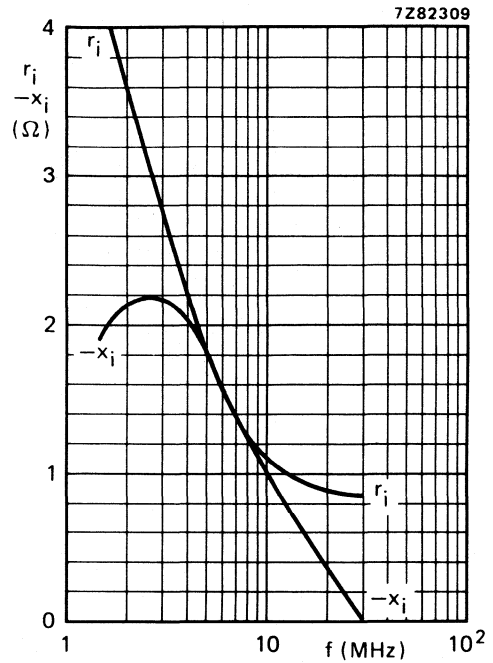


Fig. 12 Input impedance (series components) as a function of frequency.

Figs 11 and 12 are typical curves and hold for one transistor of a push-pull amplifier with cross-neutralization in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 50$  V;  $I_{C(ZS)} = 0,1$  A;  $P_L = 200$  W (P.E.P.);  $T_h = 25$  °C;  $Z_L = 5$   $\Omega$ ; neutralizing capacitor: 47 pF.



R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

$T_h = 25\text{ }^\circ\text{C}$

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)
108	50	200	typ. 45	typ. 6,5	typ. 6	typ. 67

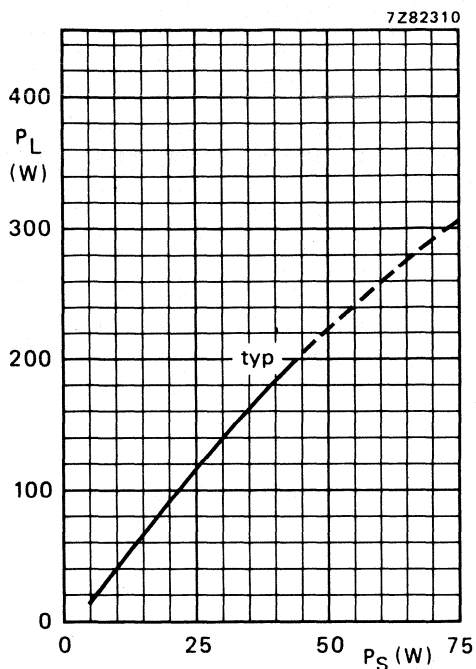


Fig. 13  $V_{CE} = 50\text{ V}$ ;  $f = 108\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ .

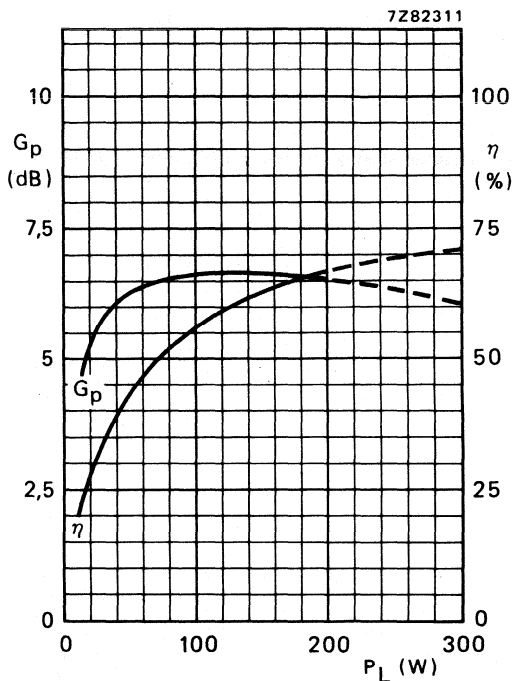


Fig. 14  $V_{CE} = 50\text{ V}$ ;  $f = 108\text{ MHz}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ; typical values.

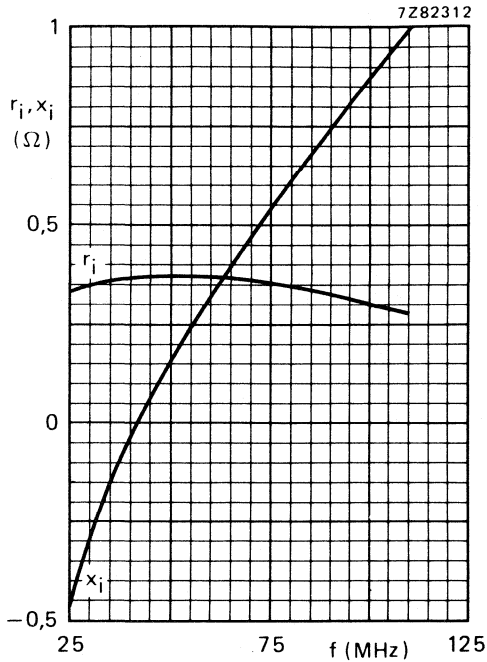


Fig. 15 Input impedance (series components).

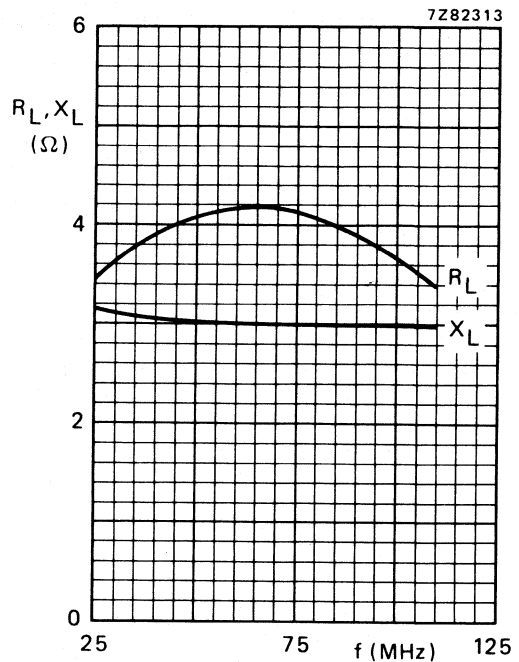


Fig. 16 Load impedance (series components).

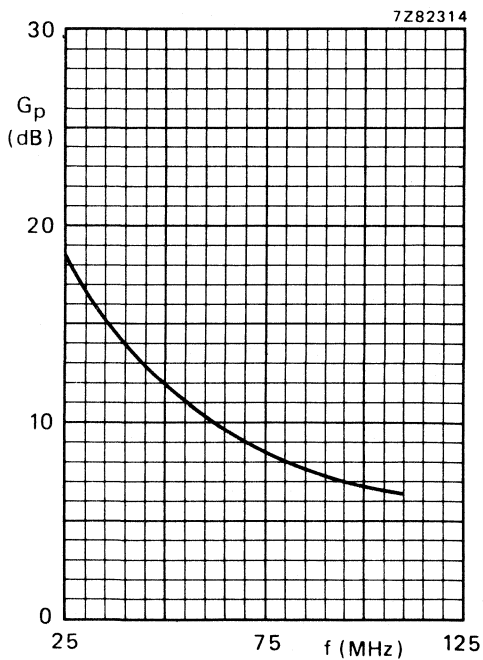


Fig. 17.

Conditions for Figs 15, 16 and 17:  
 Typical values;  $V_{CE} = 50$  V;  $P_L = 200$  W;  
 $T_h = 25$  °C; class-B operation.

R.F. performance in s.s.b. class-A operation (linear power amplifier)

$V_{CE} = 40 \text{ V}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$I_C$ A	$d_3^*$ dB	$d_5^*$ dB
typ. 50 (P.E.P.)	typ. 19	4	typ. -40	< -40

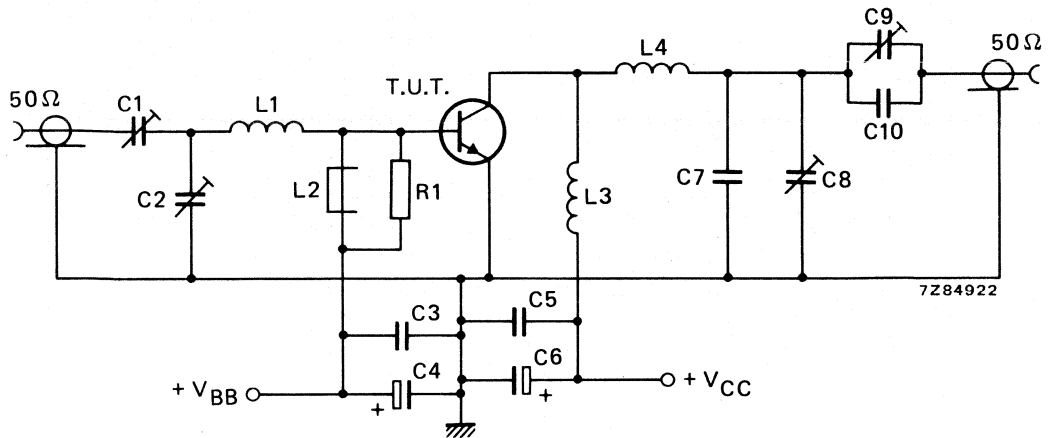


Fig. 18 Test circuit; s.s.b. class-A.

List of components:

C1 = C2 = 10 to 780 pF film dielectric trimmer

C3 = 220 nF polyester capacitor (100 V)

C4 = 100  $\mu\text{F}$ /4 V electrolytic capacitor

C5 = 2 x 330 nF polyester capacitors (100 V) in parallel

C6 = 47  $\mu\text{F}$ /63 V electrolytic capacitor

C7 = C10 = 2 x 82 pF ceramic capacitors (500 V) in parallel

C8 = C9 = 10 to 150 pF air dielectric trimmer

L1 = 45 nH; 2 turns enamelled Cu wire (1,6 mm); int. dia. 8,0 mm; length 4,0 mm; leads 2 x 3 mm

L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 110 nH; 4 turns enamelled Cu wire (2,0 mm); int. dia. 10,0 mm; length 8,0 mm; leads 2 x 2 mm

L4 = 210 nH; 5 turns enamelled Cu wire (2,0 mm); int. dia. 12,0 mm; length 10,0 mm; leads 2 x 2 mm

R1 = 27  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

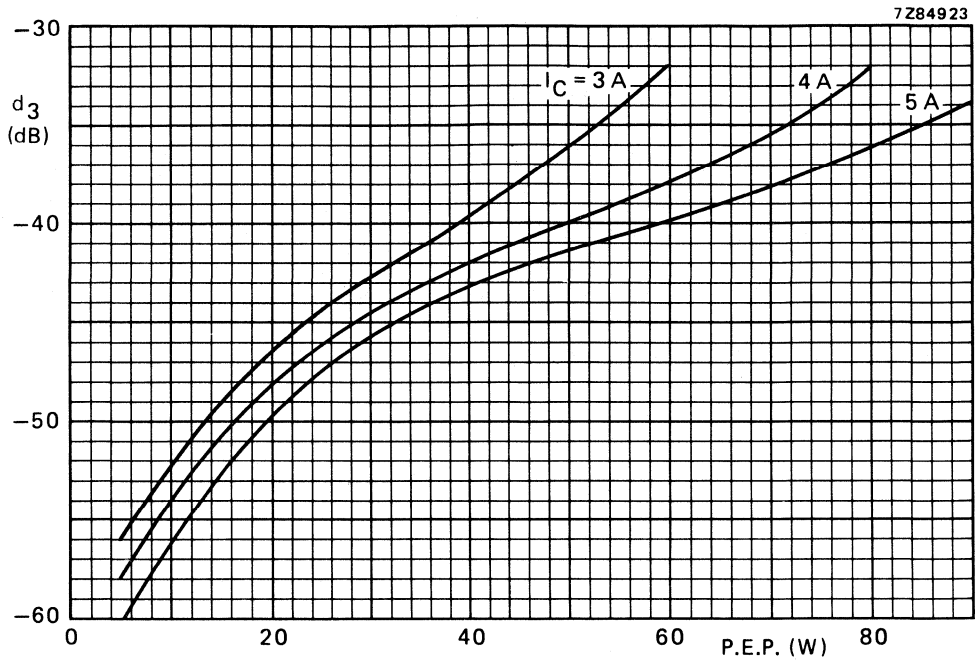


Fig. 19 Third order intermodulation distortion as a function of output power.\*  
 Typical values;  $V_{CE} = 40\text{ V}$ ;  $T_h = 25\text{ }^\circ\text{C}$ ;  $f_1 = 28,000\text{ MHz}$ ;  $f_2 = 28,001\text{ MHz}$ .

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

## H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor designed for use in class-A, AB and B operated high-power industrial and military transmitting equipment in the h.f. band.

The transistor offers excellent performance as a linear amplifier in s.s.b. applications. It is resistance stabilized and is made to withstand severe load-mismatch conditions. All leads are isolated from the flange.

The transistors are supplied in matched  $h_{FE}$  groups.

### QUICK REFERENCE DATA

R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	$I_{C(ZS)}$ A	f MHz	$P_L$ W	$G_p$ dB	$\eta_{dt}$ %	$d_3$ dB	$d_5$ dB
s.s.b. (class-AB)	28	0,1	1,6 – 28	175 (PEP)	>11,5	> 40	< -30	< -30

### MECHANICAL DATA

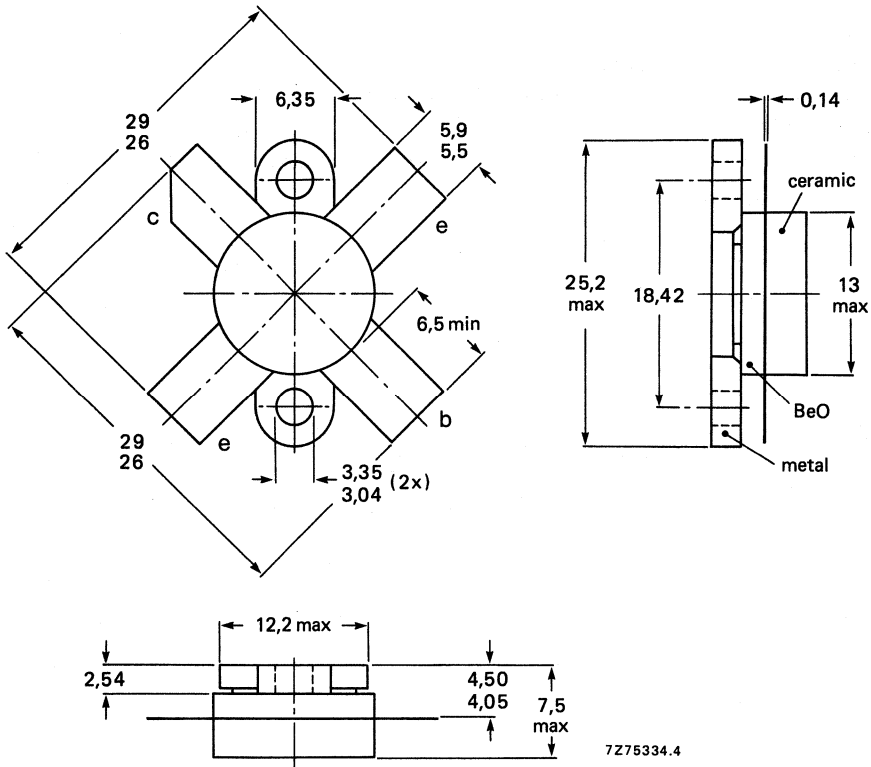
SOT-121 (see Fig. 1).

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Fig. 1 SOT-121.

Dimensions in mm



Torque on screw: min. 0,60 Nm (6,0 kg cm)  
 max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak value)

$V_{BE} = 0$

open base

$V_{CESM}$  max. 65 V

$V_{CEO}$  max. 33 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current

average

$I_{C(AV)}$  max. 15 A

peak value;  $f > 1$  MHz

$I_{CM}$  max. 50 A

Total d.c. power dissipation at  $T_h = 25^\circ\text{C}$

$P_{tot(d.c.)}$  max. 190 W

R.F. power dissipation

$f > 1$  MHz;  $T_h = 25^\circ\text{C}$

$P_{tot(rf)}$  max. 230 W

Storage temperature

$T_{stg}$   $-65$  to  $+150$   $^\circ\text{C}$

Operating junction temperature

$T_j$  max. 200  $^\circ\text{C}$

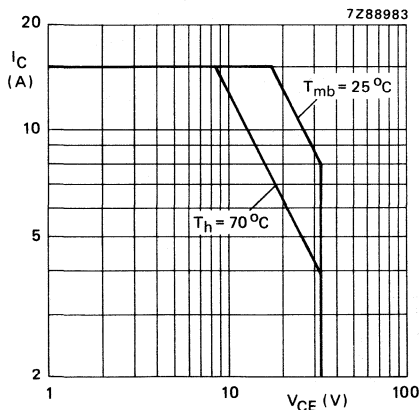


Fig. 2 D.C. SOAR.

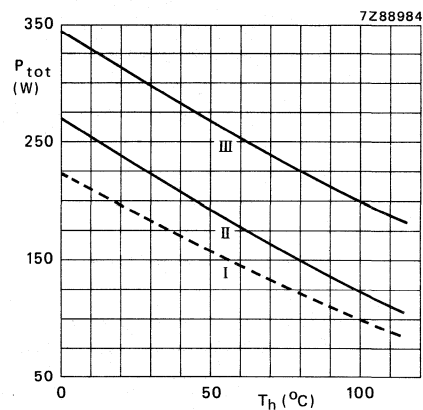


Fig. 3 Power/temperature derating curves.

- I Continuous d.c. operation
- II Continuous r.f. operation ( $f > 1$  MHz).
- III Short-time operation during mismatch; ( $f > 1$  MHz).

**THERMAL RESISTANCE** (dissipation = 120 W;  $T_h = 25^\circ\text{C}$  i.e.  $T_{mb} = 49^\circ\text{C}$ )

From junction to mounting base  
(d.c. dissipation)

$R_{th\ j-mb(dc)}$  = 0,63 K/W

From junction to mounting base  
(r.f. dissipation)

$R_{th\ j-mb(dc)}$  = 0,48 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,20 K/W

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 50\text{ mA}$

$I_C = 100\text{ mA}$ ; open base

Emitter-base breakdown voltage

$I_E = 20\text{ mA}$ ; open collector

Collector cut-off current

$V_{CE} = 33\text{ V}; V_{BE} = 0$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$

open base

$R_{BE} = 10\ \Omega$

D.C. current gain\*

$I_C = 10\text{ A}; V_{CE} = 5\text{ V}$

D.C. current gain ratio of matched devices\*

$I_C = 10\text{ A}; V_{CE} = 5\text{ V}$

Collector-emitter saturation voltage\*

$I_C = 25\text{ A}; I_B = 5\text{ A}$

Transition frequency at  $f = 100\text{ MHz}$ \*\*

$-I_E = 10\text{ A}; V_{CB} = 28\text{ V}$

$-I_E = 20\text{ A}; V_{CB} = 28\text{ V}$

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = i_e = 0; V_{CB} = 28\text{ V}$

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 0; V_{CE} = 28\text{ V}$

Collector-flange capacitance

$V_{(BR)CES}$	>	65 V
$V_{(BR)CEO}$	>	33 V
$V_{(BR)EBO}$	>	4 V
$I_{CES}$	<	20 mA
$E_{SBO}$	>	20 mJ
$E_{SBR}$	>	20 mJ
$h_{FE}$	typ. 15 to	30 50
$h_{FE1}/h_{FE2}$	<	1,2
$V_{CEsat}$	typ.	2,4 V
$f_T$	typ.	230 MHz
$f_T$	typ.	235 MHz
$C_c$	typ.	380 pF
$C_{re}$	typ.	235 pF
$C_{cf}$	typ.	4,5 pF

\* Measured under pulse conditions:  $t_p = 500\ \mu\text{s}$ .

\*\* Measured under pulse conditions:  $t_p = 300\ \mu\text{s}; \delta = 0,02$ .



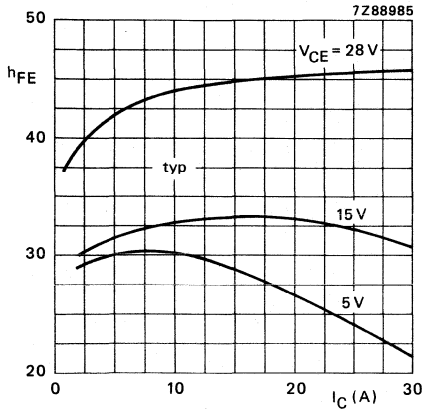


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ .

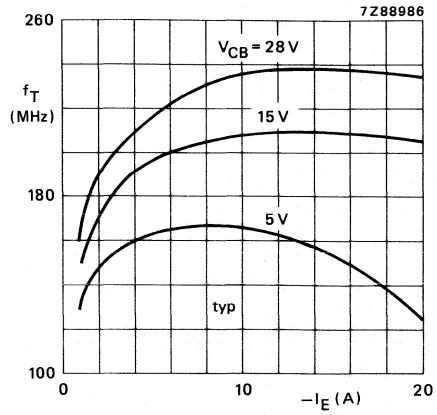


Fig. 5  $T_j = 25\text{ }^\circ\text{C}$ ;  $f = 100\text{ MHz}$ ;  
 $t_p = 300\text{ }\mu\text{s}$ .

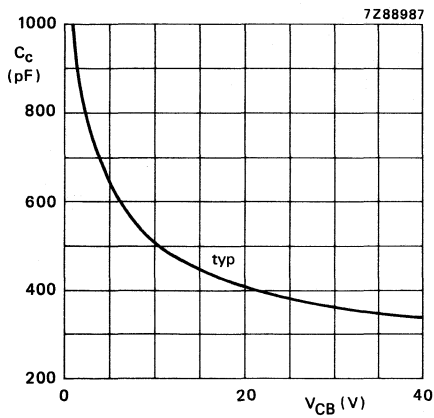


Fig. 6  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ ;  
 $T_j = 25\text{ }^\circ\text{C}$ .

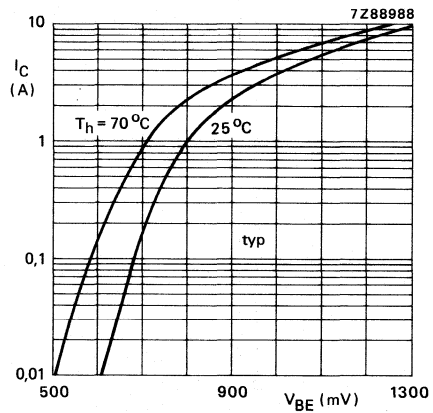


Fig. 7  $V_{CE} = 28\text{ V}$ .

## APPLICATION INFORMATION

R.F. performance in s.s.b. class-AB operation (linear power amplifier).  
 $V_{CE} = 28 \text{ V}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ .

output power W	$G_p$ dB	$\eta_{dt}$ %	$I_C$ A	$d_3^*$ dB	$d_5^*$ dB	$I_C(ZS)$ A
175 (PEP)	> 11,5 typ. 13,0	> 40 typ. 50	< 7,8 typ. 6,3	< -30 typ. -34	< -30 typ. -38	0,1

\* The stated intermodulation distortion levels are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

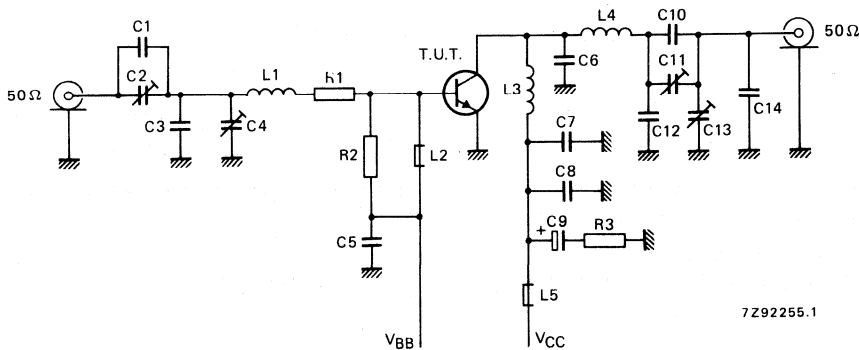


Fig. 8 Class-AB (s.s.b.) test circuit.

## List of components:

- C1 = 47 pF (500 V) multilayer ceramic chip capacitor\*
- C2 = 100 pF film dielectric trimmer
- C3 = 2 x 130 pF (300 V) multilayer ceramic chip capacitors in parallel\*
- C4 = 280 pF film dielectric trimmer
- C5 = 10 nF (50 V) multilayer ceramic chip capacitor 2222 856 13103
- C6 = 2 x 180 pF (300 V) multilayer ceramic chip capacitors in parallel\*
- C7 = 100 nF (50 V) multilayer ceramic chip capacitor 2222 856 48104
- C8 = 10 nF (50 V) multilayer ceramic chip capacitor 2222 856 13103
- C9 = 2,2  $\mu\text{F}$  - 63 V solid aluminium electrolytic capacitor
- C10 = 5 x 82 pF (500 V) multilayer ceramic chip capacitors in parallel\*
- C11 = 250 pF air dielectric trimmer
- C12 = 5 x 33 pF ceramic feed-through capacitors mounted in parallel on a brass plate
- C13 = 100 pF air dielectric trimmer
- C14 = 3 x 91 pF (500 V) multilayer ceramic chip capacitors in parallel\*
- R1 = 0,7  $\Omega$  - 7 W (7 x 4,7  $\Omega$  - 1 W carbon resistors in parallel)
- R2 = 27  $\Omega$  - 0,25 W carbon resistor
- R3 = 4,7  $\Omega$  - 0,25 W carbon resistor

\* American Technical Ceramics capacitor or capacitor of same quality.

- L1 = 73 nH; 4 turns Cu wire (1,5 mm); int. dia. 7 mm; length 9,4 mm; leads 2 x 5 mm  
 L2 = Ferroxcube wide-band h.f. choke grade 3B (cat. no. 4312 020 36640); 6 leads in parallel  
 L3 = 70,4 nH; 4 turns Cu wire (2 mm); int. dia. 7 mm; length 14,8 mm; leads 2 x 5 mm  
 L4 = 83,5 nH; 4 turns Cu wire (2 mm); int. dia. 8 mm; length 15 mm; leads 2 x 5 mm  
 L5 = Ferroxcube wide-band h.f. choke grade 3 B (cat. no. 4312 020 36640) with 6 leads in parallel

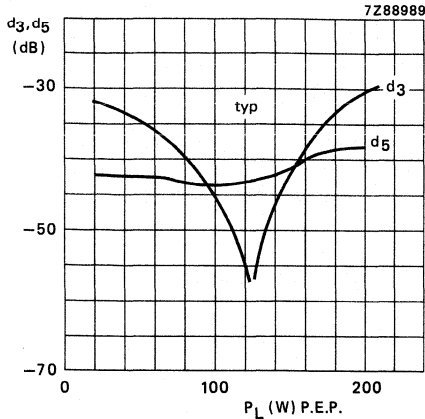


Fig. 9 Intermodulation distortion  
(see note on preceding page).

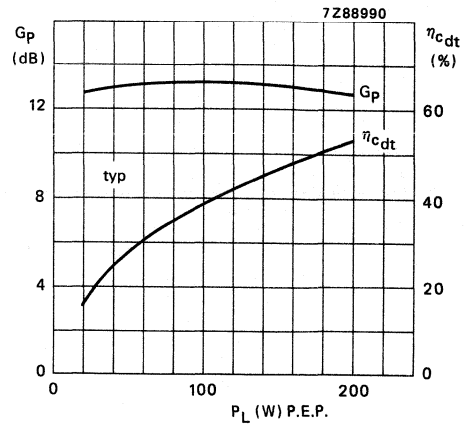


Fig. 10 Power gain and double-tone efficiency.

Conditions for Figs 9 and 10:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 0,1 \text{ A}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

### RUGGEDNESS

The BLW97 is capable of withstanding full load mismatch (VSWR = 50 through all phases) up to 150 W (P.E.P.) or a load mismatch (VSWR = 5 through all phases) up to 175 W (P.E.P.) under the following conditions:

$V_{CE} = 28 \text{ V}$ ;  $f = 28 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ .

Figures 11 and 12 on the next page present typical curves which are valid for one transistor of a push-pull amplifier in s.s.b. class-AB operation.

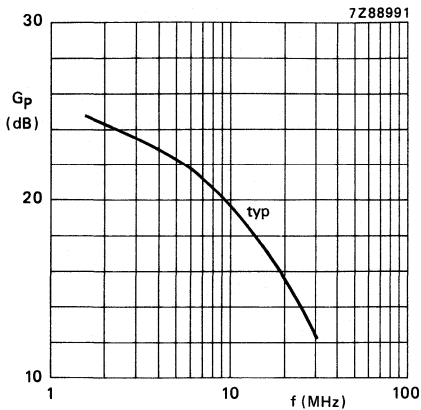


Fig. 11 Power gain.

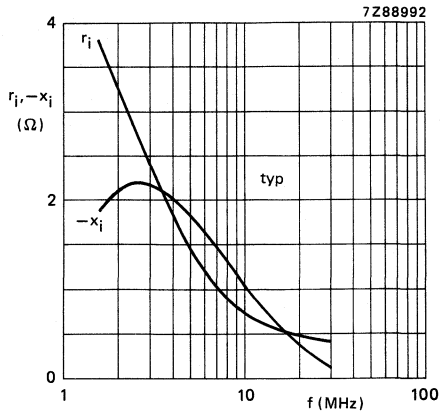


Fig. 12 Input impedance (series components).

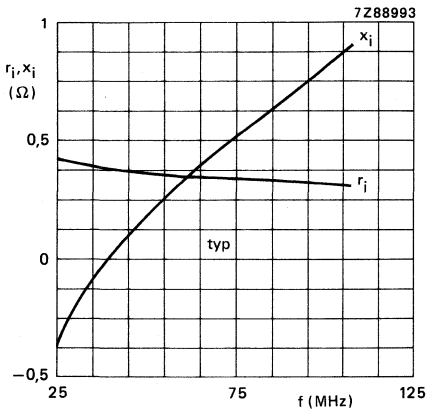


Fig. 13 Input impedance (series components).

Conditions for Figs 11 and 12:  
 $V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 0,1 \text{ A}$ ;  
 $P_L = 175 \text{ W(PEP)}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  
 $Z_L = 1,55 \text{ } \Omega$

Conditions for Figs 13, 14 and 15:  
 $V_{CE} = 28 \text{ V}$ ;  $P_L = 175 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  
 class-B operation.

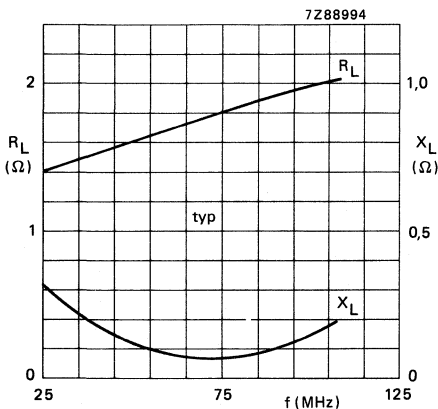


Fig. 14 Load impedance (series components).

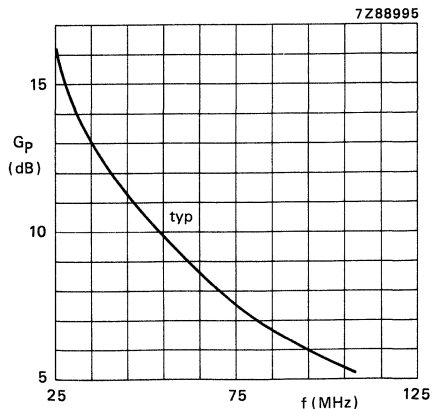


Fig. 15 Power gain.

## U.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in linear u.h.f. amplifiers of TV transposers and transmitters in band IV-V, as well as for driver stages in tube systems.

### Features:

- diffused emitter ballasting resistors for an optimum temperature profile;
- gold sandwich metallization ensures excellent reliability.

The transistor has a  $\frac{1}{4}$ " capstan envelope with ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

R.F. performance in linear amplifier

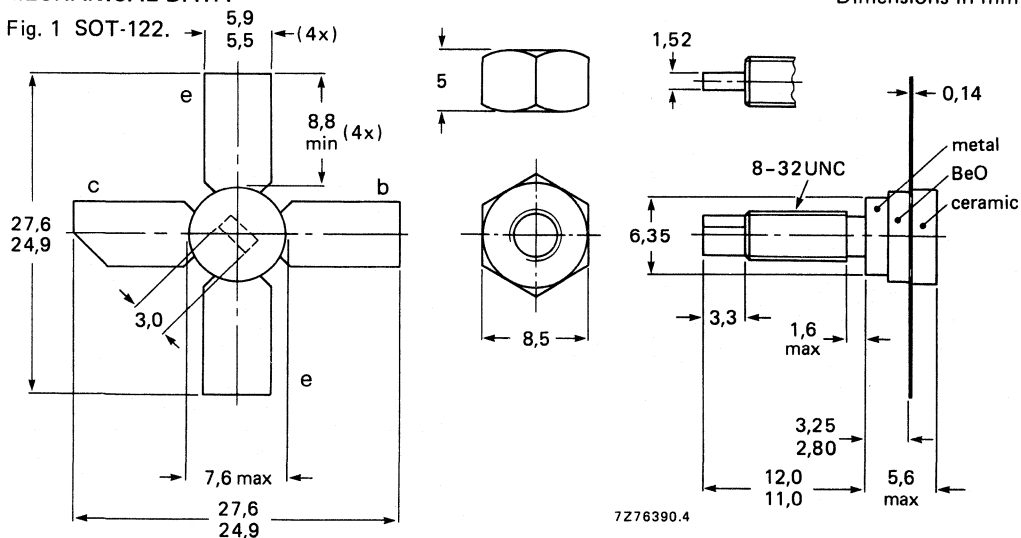
mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ mA	$T_{\text{h}}$ $^{\circ}\text{C}$	$d_{\text{im}}^*$ dB	$P_{\text{O sync}}^*$ W	$G_{\text{p}}$ dB
class-A	860	25	850	70	-60	> 3,5	> 6,5
class-A	860	25	850	25	-60	typ. 4,4	typ. 7,0

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage  
(peak value);  $V_{BE} = 0$

$V_{CESM}$  max. 50 V

open base

$V_{CEO}$  max. 27 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 3,5 V

Collector current

$I_C$  max. 2 A

d.c.

$I_{CM}$  max. 4 A

(peak value);  $f > 1$  MHz

Total power dissipation at  $T_h = 70^\circ\text{C}$

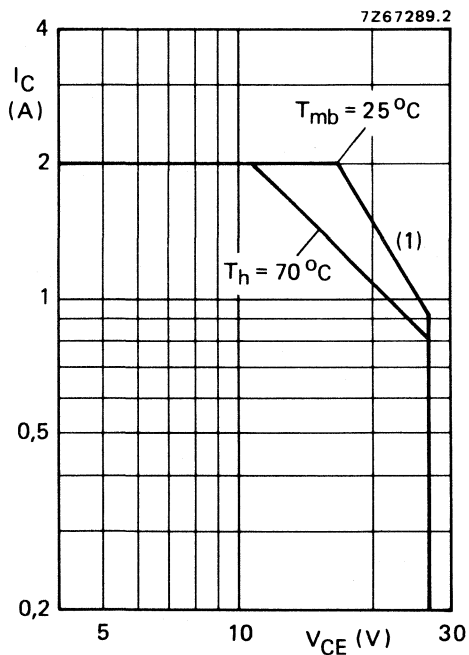
$P_{tot}$  max. 21,5 W

Storage temperature

$T_{stg}$   $-65$  to  $+150^\circ\text{C}$

Operating junction temperature

$T_j$  max.  $200^\circ\text{C}$



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

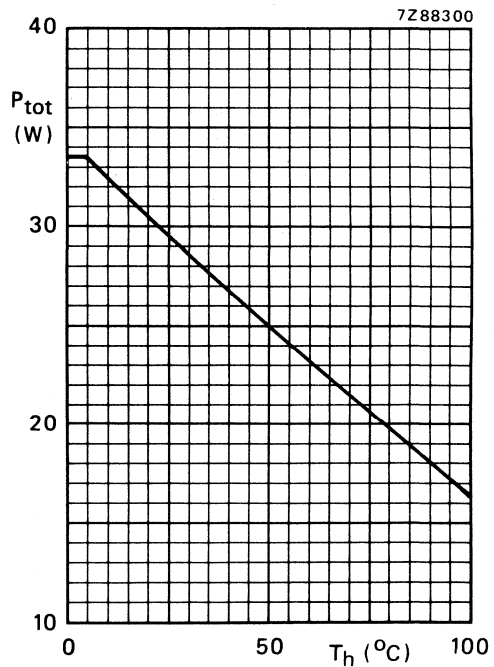


Fig. 3 Power derating curve vs. temperature.

**THERMAL RESISTANCE**(dissipation = 21,25 W;  $T_{mb} = 82,75^\circ\text{C}$ ,  $T_h = 70^\circ\text{C}$ )

From junction to mounting base

$R_{th\ j-mb} = 5,45\ \text{K/W}$

From mounting base to heatsink

$R_{th\ mb-h} = 0,6\ \text{K/W}$

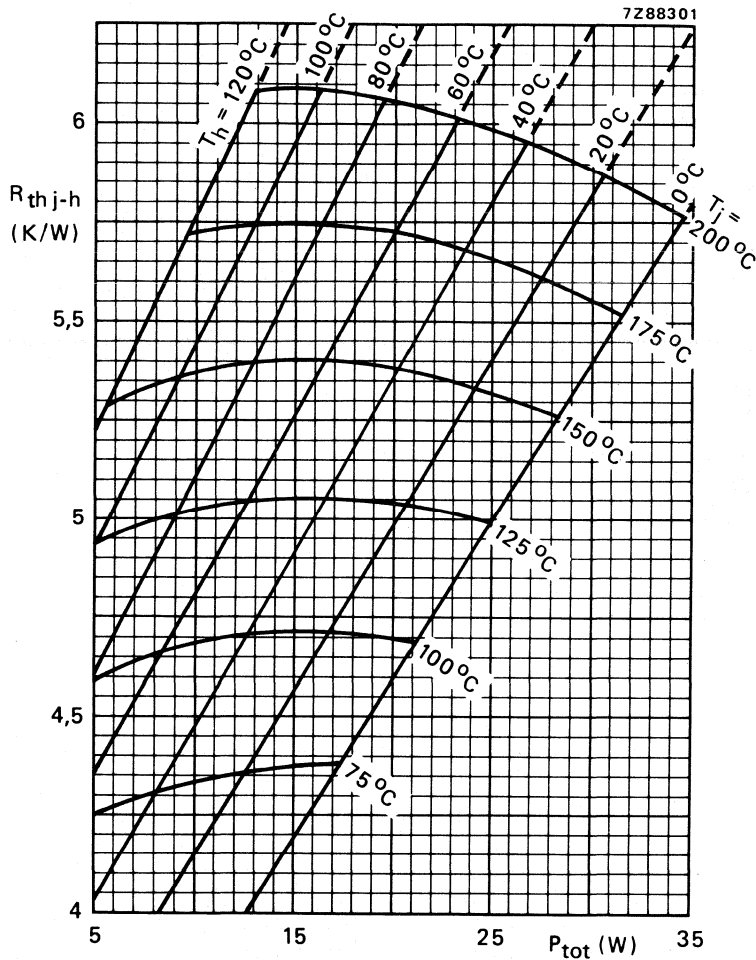


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,6\ K/W.$ )

**Example**

Nominal class-A operation (without r.f. signal):  $V_{CE} = 25\ V$ ;  $I_C = 850\ mA$ ;  $T_h = 70\ ^\circ C$ .

Fig. 4 shows:  $R_{th\ j-h}$  max. 6,05 K/W

$T_j$  max. 200  $^\circ C$

Typical device:  $R_{th\ j-h}$  typ. 5,35 K/W

$T_j$  typ. 183  $^\circ C$

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$$V_{BE} = 0; I_C = 10\text{ mA}$$

open base,  $I_C = 25\text{ mA}$

$$V_{(BR)CES} > 50\text{ V}$$

$$V_{(BR)CEO} > 27\text{ V}$$

Emitter-base breakdown voltage

open collector,  $I_E = 5\text{ mA}$

$$V_{(BR)EBO} > 3,5\text{ V}$$

D.C. current gain\*

$$I_C = 850\text{ mA}; V_{CE} = 25\text{ V}$$

$$h_{FE} > 15$$

typ. 40

Collector-emitter saturation voltage\*

$$I_C = 500\text{ mA}; I_B = 100\text{ mA}$$

$$V_{CEsat} \text{ typ. } 0,25\text{ V}$$

Transition frequency at  $f = 500\text{ MHz}$ \*\*

$$-I_E = 850\text{ mA}; V_{CB} = 25\text{ V}$$

$$f_T \text{ typ. } 2,5\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 25\text{ V}$$

$$C_c \text{ typ. } 24\text{ pF}$$

< 30 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 50\text{ mA}; V_{CE} = 25\text{ V}$$

$$C_{re} \text{ typ. } 15\text{ pF}$$

Collector-stud capacitance

$$C_{CS} \text{ typ. } 1,2\text{ pF}$$

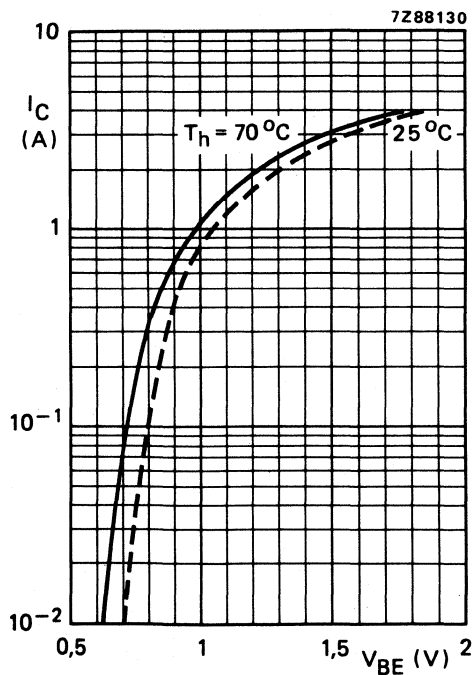


Fig. 5 Typical values;  $V_{CE} = 25\text{ V}$ .

\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}$ ;  $\delta \leq 0,02$ .

\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}$ ;  $\delta \leq 0,01$ .



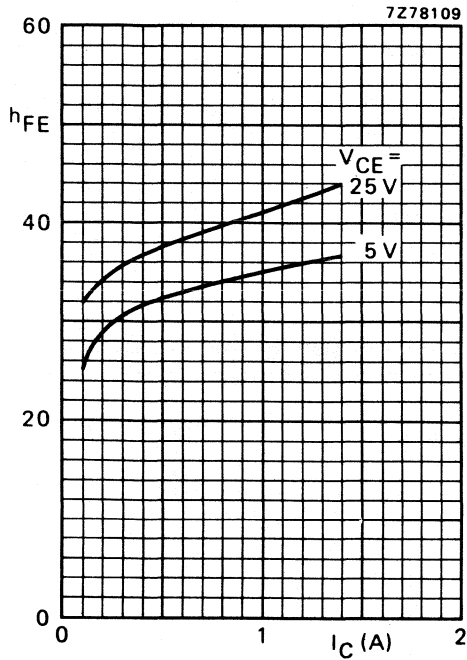


Fig. 6 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

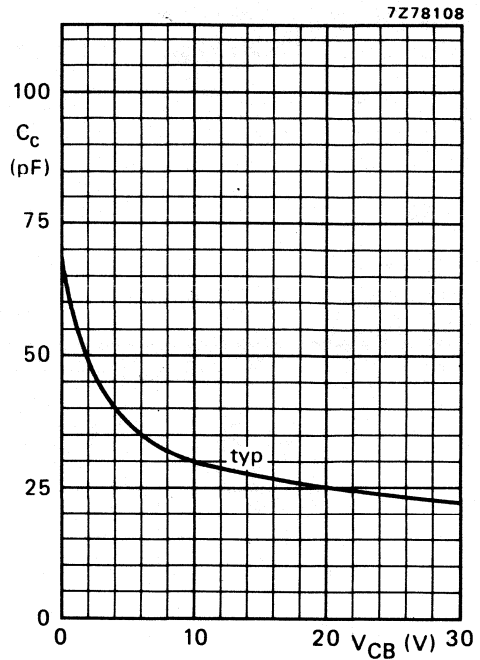


Fig. 7  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

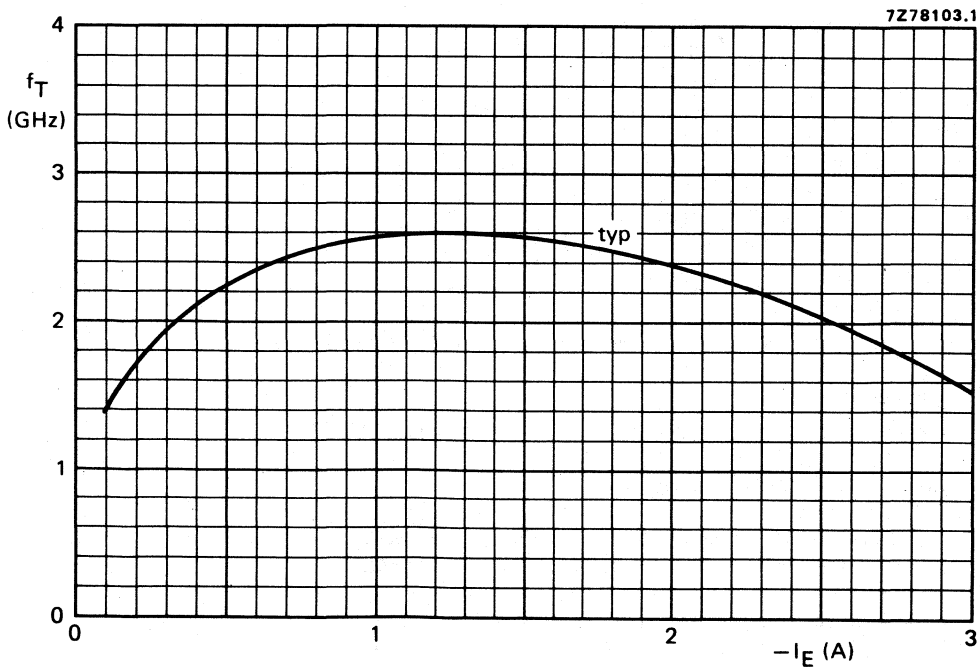


Fig. 8  $V_{CB} = 25\text{ V}$ ;  $f = 500\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in u.h.f. class-A operation (linear power amplifier)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (mA)	$T_{\text{h}}$ (°C)	$d_{\text{im}}$ (dB)*	$P_{\text{O sync}}$ (W)*	$G_{\text{p}}$ (dB)
860	25	850	70	-60	> 3,5	> 6,5
860	25	850	70	-60	typ. 3,8	typ. 7,0
860	25	850	25	-60	typ. 4,4	typ. 7,0

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

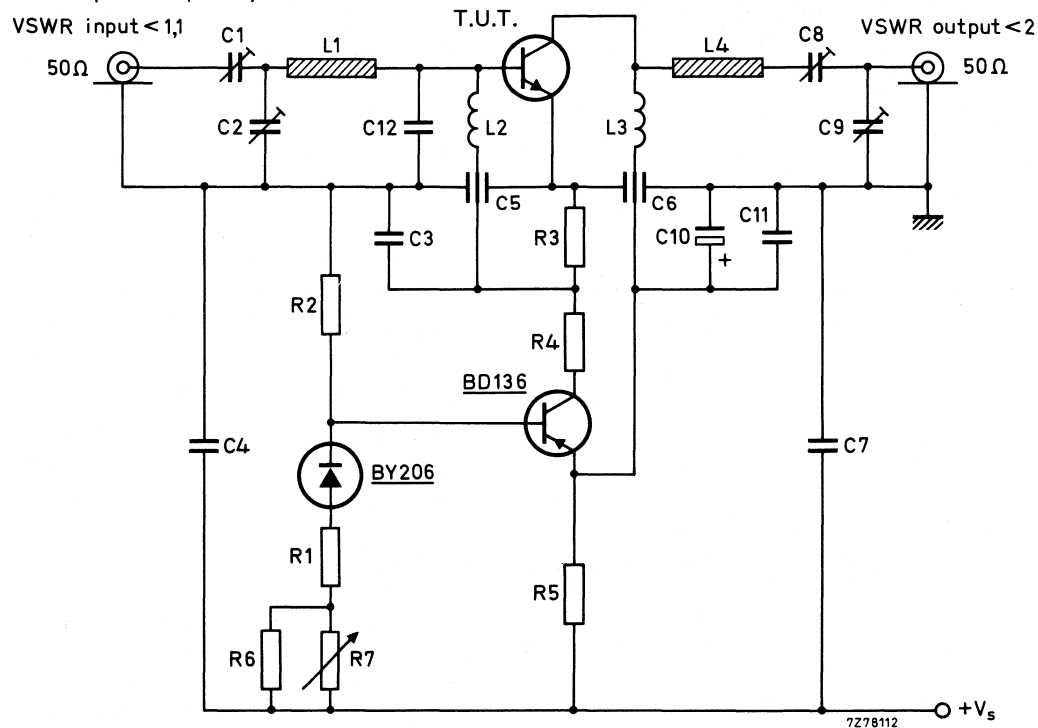


Fig. 9 Class-A test circuit at  $f_{\text{vision}} = 860$  MHz.

## List of components:

- C1 = C2 = 1,4 to 5,5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C3 = C4 = 100 nF polyester capacitor
- C5 = C6 = 1 nF feed-through capacitor
- C7 = 5,6 pF ceramic capacitor
- C8 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)
- C9 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)
- C10 = 10  $\mu\text{F}/40$  V solid aluminium electrolytic capacitor
- C11 = 470 nF polyester capacitor
- C12 = 2 x 3,3 pF chip capacitors (in parallel)

List of components: (continued)

R1 = 150  $\Omega$  carbon resistor (0,25 W)

R2 = 1,8 k $\Omega$  carbon resistor (0,5 W)

R3 = 33  $\Omega$  carbon resistor (0,5 W)

R4 = 220  $\Omega$  carbon resistor (1 W)

L1 = stripline (13,6 mm x 6,9 mm)

L2 = microchoke 0,47  $\mu$ H (cat. no. 4322 057 04770)

L3 = 1 turn Cu wire (1 mm); internal diameter 5,5 mm; leads 2 x 5 mm

L4 = stripline (40,8 mm x 6,9 mm)

L1 and L4 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1,5 mm.

R5 = 4 x 12  $\Omega$  carbon resistors in parallel (1 W each)

R6 = 1 k $\Omega$  carbon resistor (0,25 W)

R7 = 220  $\Omega$  carbon potentiometer (0,25 W)

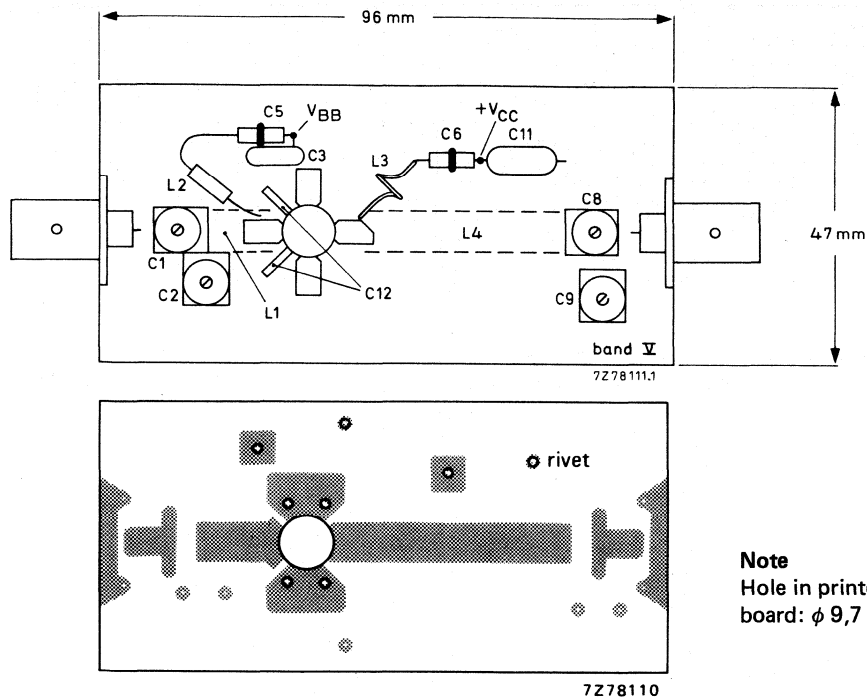


Fig. 10 Component layout and printed circuit board for 860 MHz class-A test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board, the other side is unetched copper to serve as a ground-plane. Earth connections are made by hollow rivets. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.

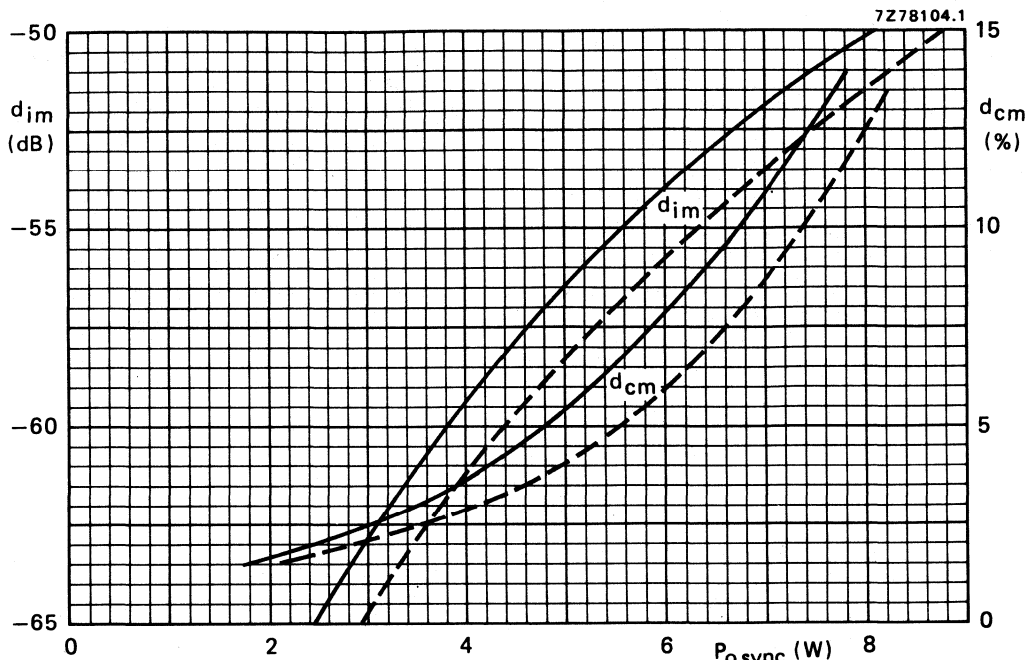


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and cross-modulation distortion ( $d_{cm}$ )\*\* as a function of  $P_{o\_sync}$ . Typical values;  $V_{CE} = 25\text{ V}$ ;  $I_C = 850\text{ mA}$ ; ---  $T_h = 25\text{ °C}$ ; —  $T_h = 70\text{ °C}$ ;  $f_{vision} = 860\text{ MHz}$ .

- \* Three-tone test method (vision carrier  $-8\text{ dB}$ , sound carrier  $-7\text{ dB}$ , sideband signal  $-16\text{ dB}$ ), zero dB corresponds to peak sync level.  
Intermodulation distortion of input signal  $\leq -75\text{ dB}$ .
- \*\* Two-tone test method (vision carrier  $0\text{ dB}$ , sound carrier  $-7\text{ dB}$ ), zero dB corresponds to peak sync level.  
Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from  $0\text{ dB}$  to  $-20\text{ dB}$ .

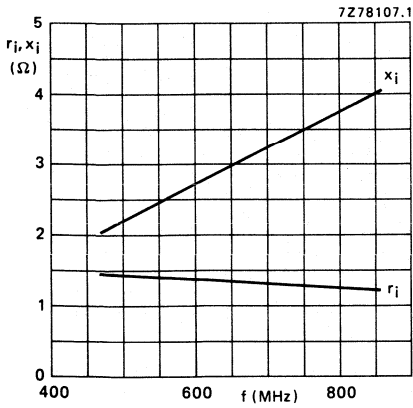


Fig. 12 Input impedance (series components).

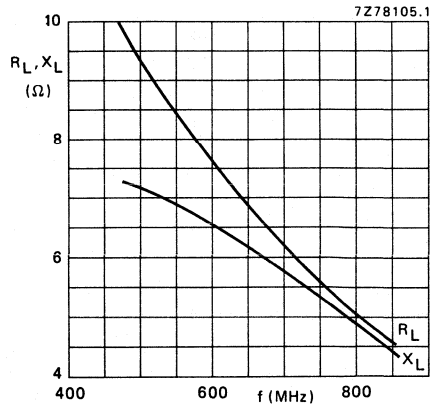


Fig. 13 Load impedance (series components).

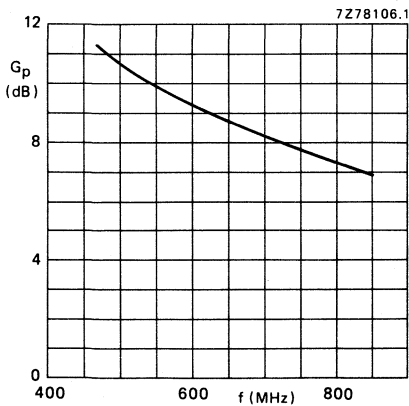


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 25$  V;  $I_C = 850$  mA; class-A operation;  $T_h = 70$  °C.



## H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-AB and B operated high-power mobile transmitting equipment in the h.f. band.

The transistors are resistance-stabilized and are guaranteed to withstand severe load mismatch conditions. They are supplied in matched  $h_{FE}$  groups.

The transistor has a 1/2 in 4-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

### QUICK REFERENCE DATA

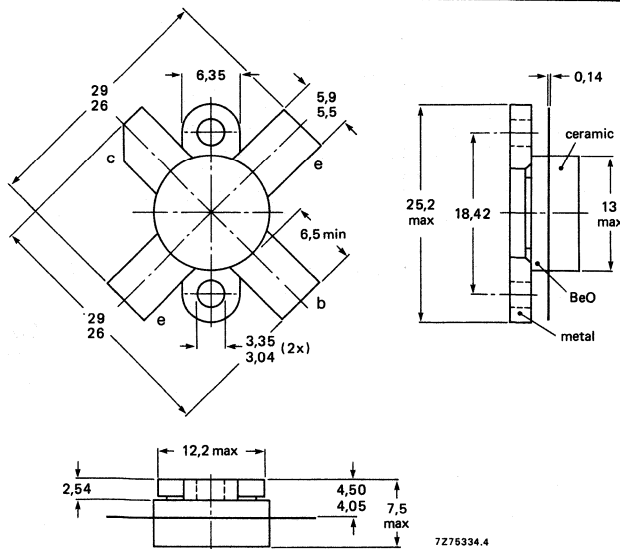
R.F. performance at  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	$I_{C(ZS)}$ A	f MHz	$P_L$ W	$G_p$ dB	$\eta_{dt}$ %	$d_3^*$ dB	$d_5^*$ dB
s.s.b. class-AB	12,5	0,15	1,6-28	80 (P.E.P.)	> 12,5	> 35	< -24	< -24

\* See note on page 4.

### MECHANICAL DATA

Fig. 1 SOT-121.



Torque on screw: min. 0,60 Nm (6,0 kg cm)  
max. 0,75 Nm (7,5 kg cm)

Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage

(peak value);  $V_{BE} = 0$

open base

$V_{CESM}$  max. 36 V

$V_{CEO}$  max. 17 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current

average

$I_{C(AV)}$  max. 18 A

(peak value);  $f > 1$  MHz

$I_{CM}$  max. 55 A

D.C. power dissipation at  $T_{mb} = 25^\circ\text{C}$

$P_{tot(d.c.)}$  max. 154 W

R.F. power dissipation

$f > 1$  MHz;  $T_{mb} = 25^\circ\text{C}$

$P_{tot(rf)}$  max. 192 W

Storage temperature

$T_{stg}$   $-65$  to  $+150^\circ\text{C}$

Operating junction temperature

$T_j$  max.  $200^\circ\text{C}$

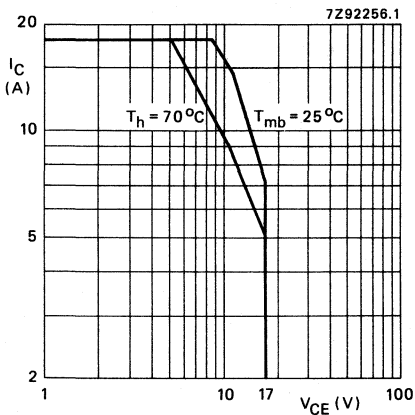


Fig. 2 D.C. SOAR.

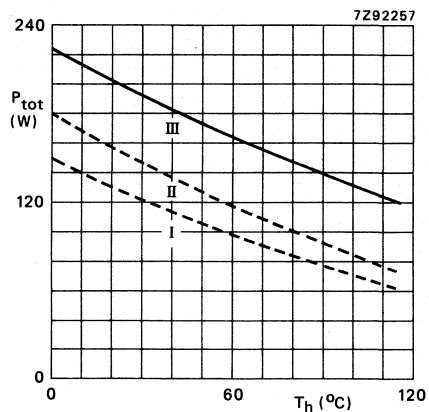


Fig. 3 Power/temperature derating curves.

- I Continuous d.c. operation
- II Continuous r.f. operation; ( $f > 1$  MHz)
- III Short-time r.f. operation during mismatch ( $f > 1$  MHz)

**THERMAL RESISTANCE**

Dissipation = 100 W;  $T_{mb} = 25^\circ\text{C}$

From junction to mounting base  
(d.c. dissipation)

$R_{th\ j-mb(dc)}$  = 1,00 K/W

From junction to mounting base  
(r.f. dissipation)

$R_{th\ j-mb(rf)}$  = 0,75 K/W

From mounting base to heatsink

$R_{th\ mb-h}$  = 0,2 K/W



**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 50\text{ mA}$

open base;  $I_C = 100\text{ mA}$

Emitter-base breakdown voltage

open collector;  $I_E = 20\text{ mA}$

Collector cut-off current

$V_{BE} = 0; V_{CE} = 17\text{ V}$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$

open base

$R_{BE} = 10\ \Omega$

D.C. current gain\*

$I_C = 10\text{ A}; V_{CE} = 5\text{ V}$

D.C. current gain ratio of matched devices\*

$I_C = 10\text{ A}; V_{CE} = 5\text{ V}$

Collector-emitter saturation voltage\*

$I_C = 25\text{ A}; I_B = 5\text{ A}$

Transition frequency at  $f = 100\text{ MHz}$ \*\*

$-I_E = 10\text{ A}; V_{CB} = 12,5\text{ V}$

$-I_E = 20\text{ A}; V_{CB} = 12,5\text{ V}$

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 12,5\text{ V}$

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 0; V_{CE} = 12,5\text{ V}$

Collector-flange capacitance

$V_{(BR)CES}$	>	36 V
$V_{(BR)CEO}$	>	17 V
$V_{(BR)EBO}$	>	4 V
$I_{CES}$	<	20 mA
$E_{SBO}$	>	12,5 mJ
$E_{SBR}$	>	12,5 mJ
$h_{FE}$	typ. 15 to	35 80
$h_{FE1}/h_{FE2}$	<	1,2
$V_{CEsat}$	typ.	1,7 V
$f_T$	typ.	290 MHz
$f_T$	typ.	275 MHz
$C_c$	typ.	400 pF
$C_{re}$	typ.	265 pF
$C_{cf}$	typ.	4,5 pF

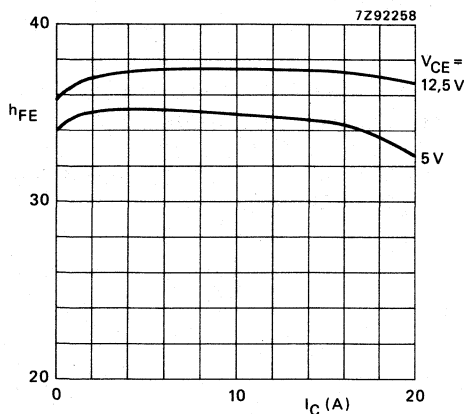


Fig. 4  $T_j = 25\text{ }^\circ\text{C}$ .

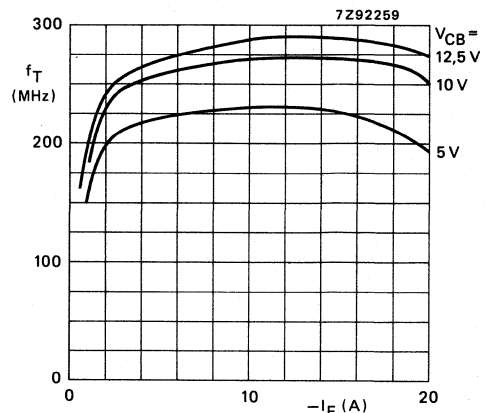


Fig. 5  $f = 100\text{ MHz}; T_j = 25\text{ }^\circ\text{C}$ .

\* Measured under pulse conditions:  $t_p = 500\ \mu\text{s}$ .

\*\* Measured under pulse conditions:  $t_p = 300\ \mu\text{s}; \delta = 0,02$ .

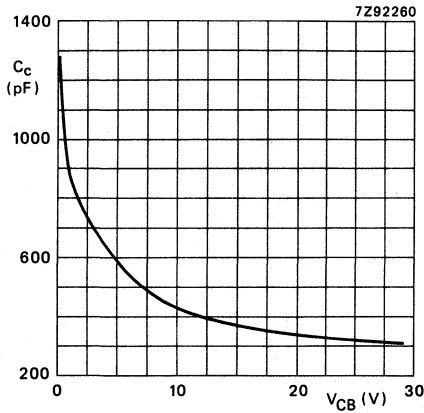


Fig. 6  $I_E = I_e = 0$ ;  $f = 1$  MHz;  
 $T_j = 25$  °C.

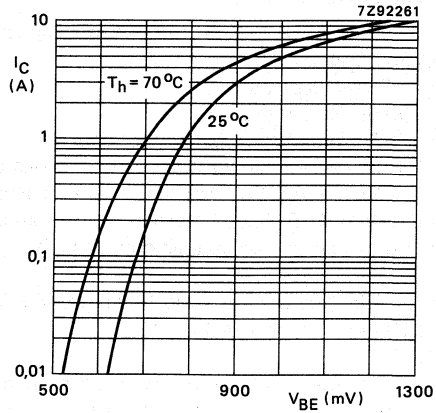


Fig. 7  $V_{CE} = 12,5$  V; typ. values.

**APPLICATION INFORMATION**

R.F. performance in s.s.b. class-AB operation (linear power amplifier)  $V_{CE} = 12,5$  V;  $T_h = 25$  °C;  
 $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz

output power W	Gp dB	$\eta_{dt}$ %	Ic A	d3* dB	d5* dB	Ic(ZS) A
80 (P.E.P.)	> 12,5 typ. 14	> 35 typ. 40	< 9,1 typ. 7,6	< -24 typ. -27	< -24 typ. -36	0,15

\* The stated intermodulation distortion levels are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

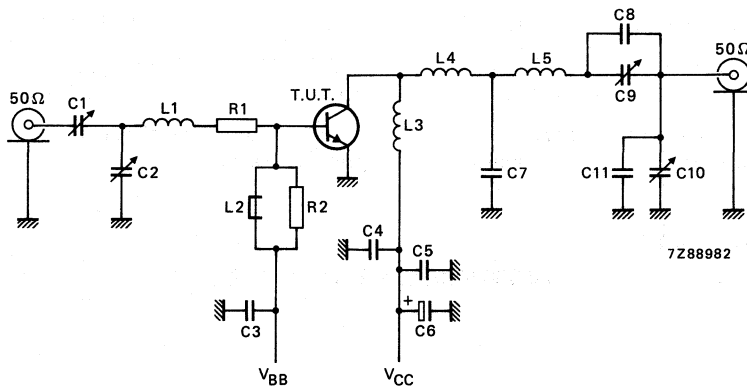


Fig. 8 Class-AB test circuit, s.s.b.

## List of components:

- C1 = C2 = 270 pF film dielectric trimmer capacitor  
 C3 = 220 nF chip capacitor  
 C4 = 1 nF chip capacitor  
 C5 = 100 nF chip capacitor  
 C6 = 47  $\mu$ F – 63 V electrolytic capacitor  
 C7 = 3 x 180 pF multilayer ceramic chip capacitors in parallel\*  
 C8 = 2 x 150 pF (500 V) multilayer ceramic chip capacitors\*  
 C9 = C10 = 100 pF film dielectric trimmer capacitor  
 C11 = 150 pF multilayer ceramic chip capacitor\*

- R1 = 4 x 1,2  $\Omega$  carbon resistors in parallel (4 x 0,125 W)  
 R2 = 27  $\Omega$  carbon resistor (0,5 W)

- L1 = 3 turns Cu wire (2 mm); int. dia. 8 mm; length 9 mm; leads 2 x 5 mm  
 L2 = Ferroxcube wide-band h.f. choke (cat. no. 4312 020 36640)  
 L3 = L4 = 2 turns Cu wire (2 mm); int. dia. 8 mm; length 5 mm; leads 2 x 5 mm  
 L5 = 3 turns Cu wire (2 mm); int. dia. 8,5 mm; length 8,5 mm; length 8,5 mm; leads 2 x 5 mm

\* American Technical Ceramics capacitor type 100 B or capacitor of same quality.

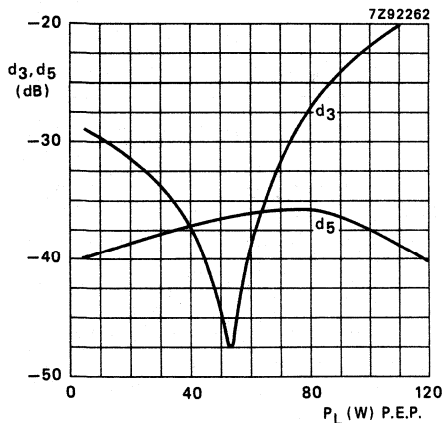


Fig. 9 Intermodulation distortion (see note on preceding page); typ. values.

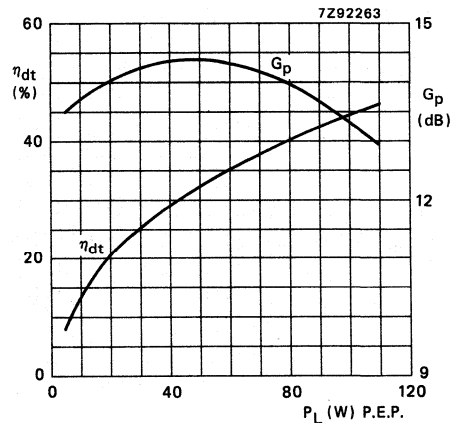


Fig. 10 Double-tone efficiency and power gain; typ. values.

Conditions for Figs 9 and 10:

$V_{CE} = 12,5$  V;  $I_{C(ZS)} = 0,15$  A;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  $T_h = 25$  °C.

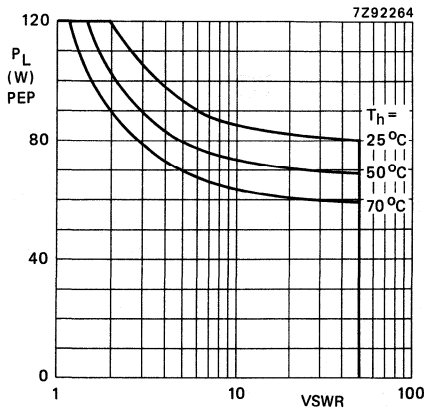


Fig. 11 R.F. SOAR: s.s.b. class-AB operation;  
 $V_{CE} = 15 \text{ V}$ ;  $R_{th \text{ mb-h}} = 0,2 \text{ K/W}$ ;  
 $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ .

This graph shows the permissible output power as a function of VSWR during mismatch conditions with the heatsink temperature as parameter.

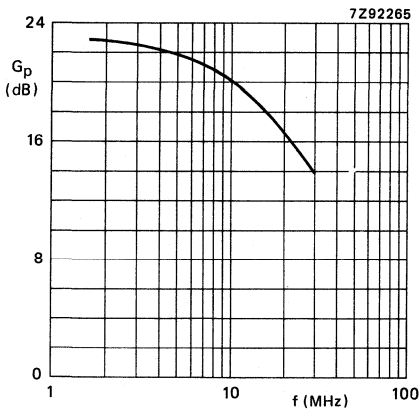


Fig. 12 Power gain.

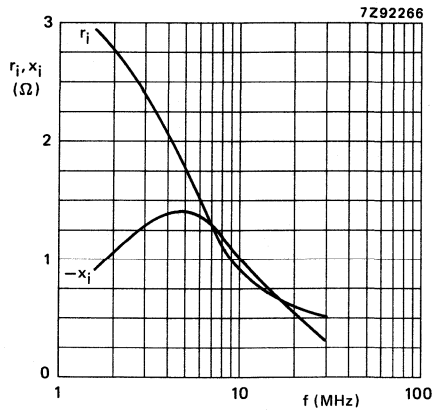


Fig. 13 Input impedance (series components).

Conditions for Figs 12 and 13:

$V_{CE} = 12,5 \text{ V}$ ;  $I_{C(ZS)} = 0,15 \text{ A}$ ;  $Z_L = 0,65 \Omega$ ;  $P_L = 80 \text{ W (PEP)}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .

The curves in Figs 12 and 13 are typical and hold for one transistor of a push-pull amplifier in s.s.b. class-AB operation.

### H.F./V.H.F. POWER TRANSISTOR

N-P-N epitaxial planar transistor intended for s.s.b. in class-A and AB and in f.m. transmitting applications in class-C with a supply voltage up to 28 V. The transistor is resistance stabilized and tested under severe load mismatch conditions. It has a 1/4" capstan envelope with a moulded cap. All leads are isolated from the stud.

**QUICK REFERENCE DATA**

mode of operation	V <sub>CE</sub> V	f <sub>1</sub> MHz	f <sub>2</sub> MHz	P <sub>L</sub> W	G <sub>p</sub> dB	d <sub>3</sub> dB	I <sub>C</sub> A	η <sub>dt</sub> %
s.s.b. (class-A)	26	28,000	28,001	0-8(P.E.P.)	> 18	< -40	< 1,2	-
s.s.b. (class-AB)	28	28,000	28,001	25(P.E.P.)	> 18	typ. -35	typ. 1,28	typ. 35

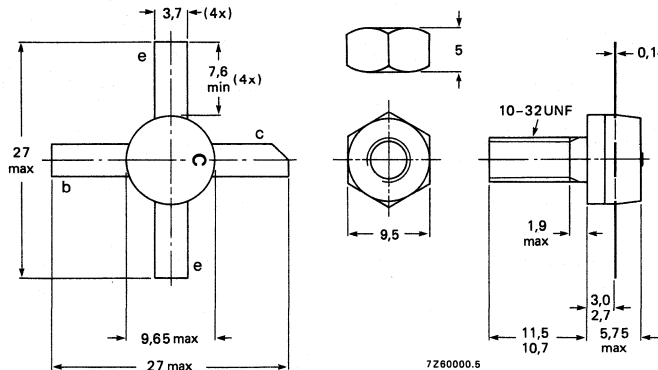
  

mode of operation	V <sub>CE</sub> V	f MHz	P <sub>S</sub> W	P <sub>L</sub> W	G <sub>p</sub> dB	I <sub>C</sub> A	η %	Z <sub>i</sub> Ω	Y <sub>L</sub> mS
c.w. (class-B)	28	70	typ. 0,5	25	typ. 17	typ. 1,49	typ. 60	0,53 - j1,4	42,5 - j54

**MECHANICAL DATA**

Dimensions in mm

Fig. 1 SOT-56.



Torque on nut: min. 1,5 Nm  
(15 kg cm)  
max. 1,7 Nm  
(17 kg cm)

Diameter of clearance hole in heatsink: max. 4,9 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer  
or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage  
open emitter;  $I_C = 50\text{ mA}$  $V_{(BR)CBO} > 65\text{ V}$ Collector-emitter voltage  
open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 36\text{ V}$ Emitter-base voltage  
open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4.0\text{ V}$ 

## Transient energy

 $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base	E	>	8	ms
$-V_{BE} = 1.5\text{ V}; R_{BE} = 33\Omega$	E	>	8	ms

## D.C. current gain

 $I_C = 1.0\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 50  
10 to 100

## Transition frequency

 $I_C = 3.0\text{ A}; V_{CE} = 20\text{ V}$  $f_T$  typ. 500 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 30\text{ V}$  $C_c$  typ. 50 pF  
< 65 pF

## Feedback capacitance

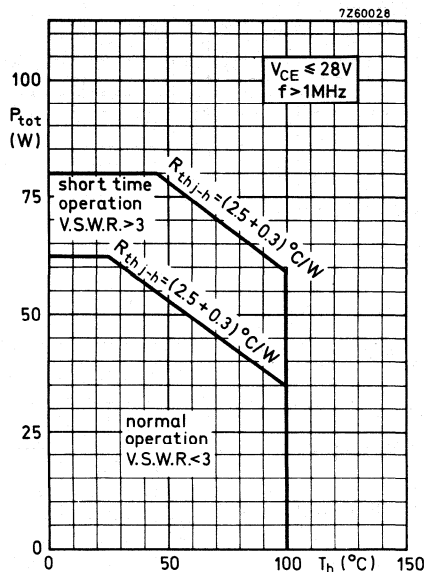
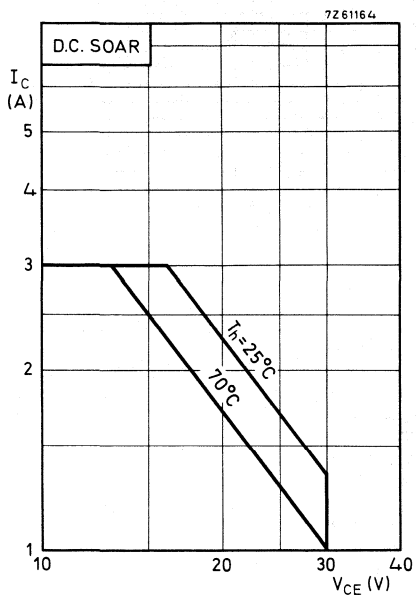
 $I_C = 100\text{ mA}; V_{CE} = 30\text{ V}$  $-C_{re}$  typ. 31 pF

## Collector-stud capacitance

 $C_{cs}$  typ. 2 pF

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	65	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4.0	V
Collector current (average)	$I_{C(AV)}$	max.	3.0	A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	6	A
Total power dissipation up to $T_h = 25$ °C $f > 1$ MHz	$P_{tot}$	max.	62.5	W



Storage temperature

$T_{stg}$  -30 to +200 °C

Operating junction temperature

$T_j$  max. 200 °C

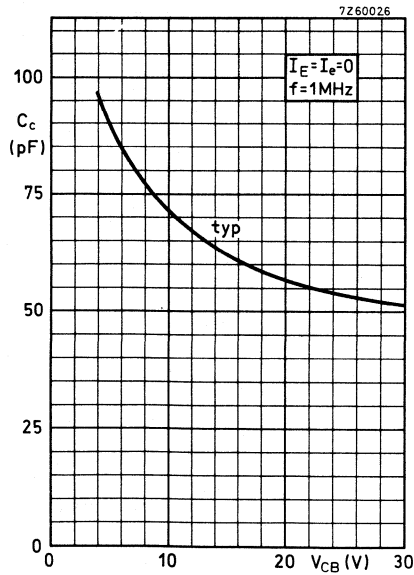
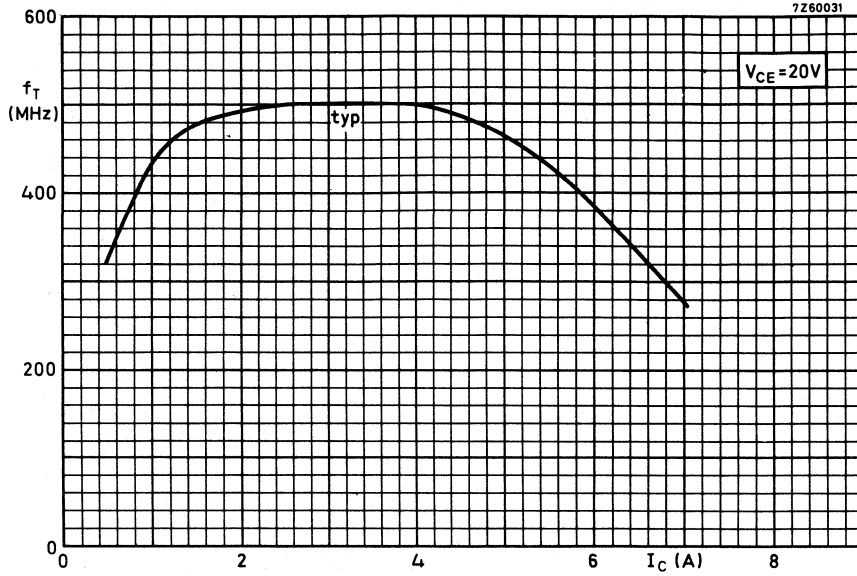
**THERMAL RESISTANCE**

From junction to mounting base

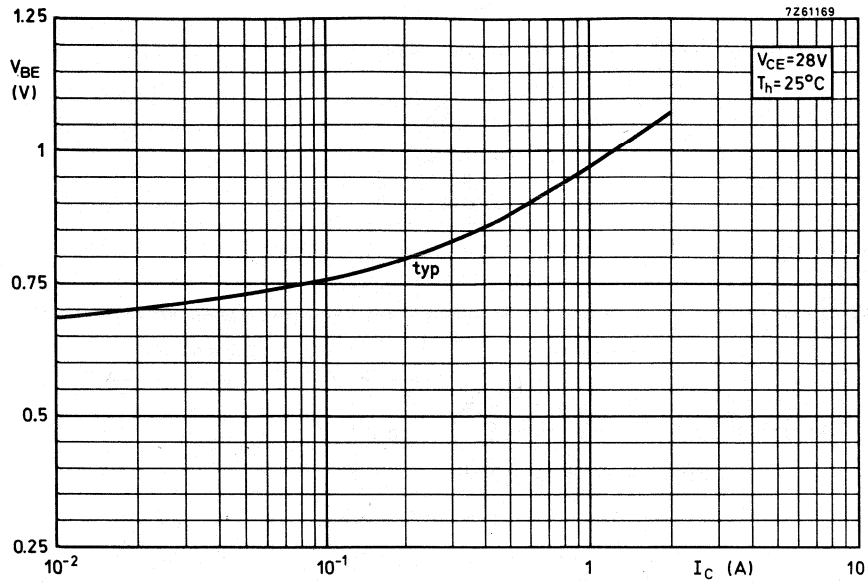
$R_{th\ j-mb} = 2.5$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0.3$  K/W







APPLICATION INFORMATION

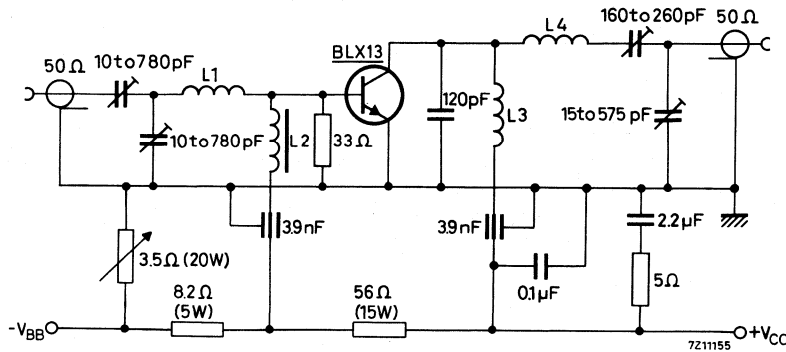
R. F. performance in S. S. B. operation (linear power amplifier)

$V_{CE} = 26 \text{ V}$ ;  $T_h$  up to  $25 \text{ }^\circ\text{C}$   
 $f_1 = 28.000 \text{ MHz}$ ;  $f_2 = 28.001 \text{ MHz}$

output power (W)	$G_p$ (dB)	$d_3$ (dB) <sup>1)</sup>	$I_C$ (A)	Class
0.8 (PEP)	> 18	< -40	< 1.2	A

Test circuit:

S.S.B.  
class A



L1 = 3 turns enamelled Cu wire (1.5 mm); winding pitch 2.5 mm; int. diam. 7 mm  
leads 50 mm totally

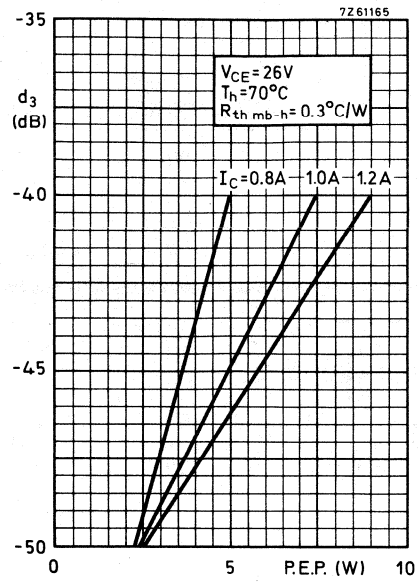
L2 = 7 turns enamelled Cu wire (0.7 mm) on 3H1 toroid; 60  $\mu\text{H}$   
(code number of 3H1: 4322 020 36620)

L3 = 4 turns enamelled Cu wire (1.5 mm); winding pitch 2.5 mm; int. diam. 10 mm

L4 = 7 turns enamelled Cu wire (1.5 mm); winding pitch 2.5 mm; int. diam. 12 mm

-----  
 Detailed information for a wide band application  
 1.6 to 28 MHz available on request  
 -----

<sup>1)</sup> Stated figures are maxima encountered at any driving level between the specified values of PEP and are referred to the according level of either of the equal ampl. tones. Relative to the according peak envelope power these figures should be increased by 6 dB.



## APPLICATION INFORMATION

R.F. performance in s.s.b. class-AB operation (linear power amplifier)

 $V_{CE} = 28 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	Gp dB	$\eta_{dt}$ %	$I_C$ A	$d_3^*$ dB	$I_C(ZS)$ mA	$T_h$ °C
25 (P.E.P.)	> 18	typ. 35	typ. 1,28	typ. -35	25	25

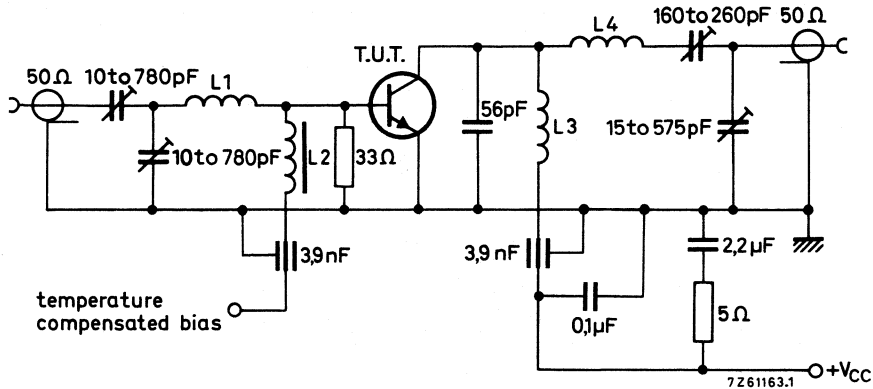
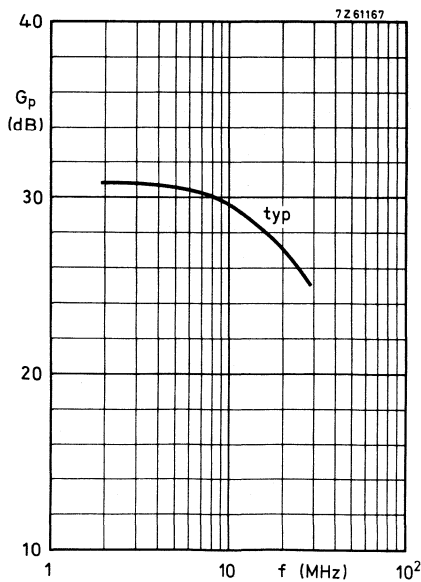
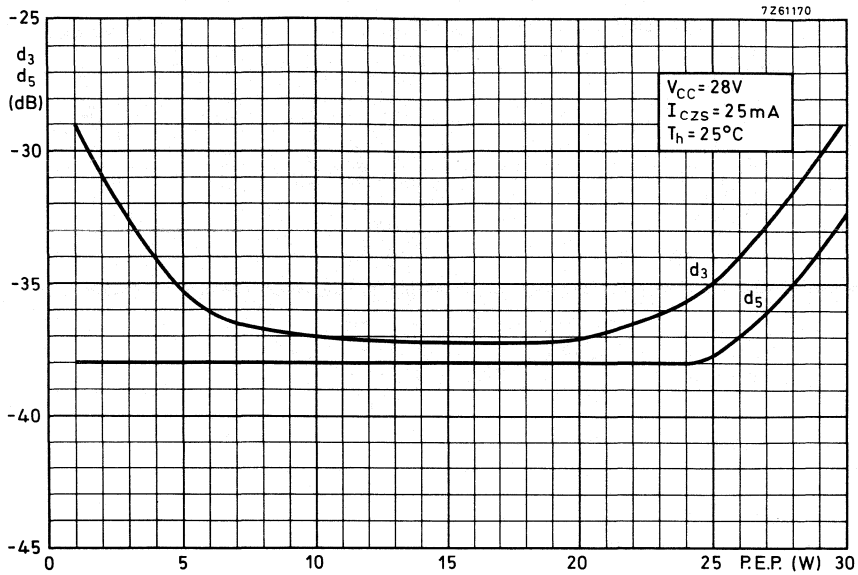


Fig. 9 Test circuit; s.s.b. class-AB.

## List of components:

- L1 = 3 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 7,0 mm; leads 50 mm (total)
- L2 = 7 turns enamelled Cu wire (0,7 mm) on 3H1 toroid; 60  $\mu\text{H}$  (cat. no. of 3H1: 4322 020 36620)
- L3 = 4 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 10 mm
- L4 = 7 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 12 mm

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.



Conditions:

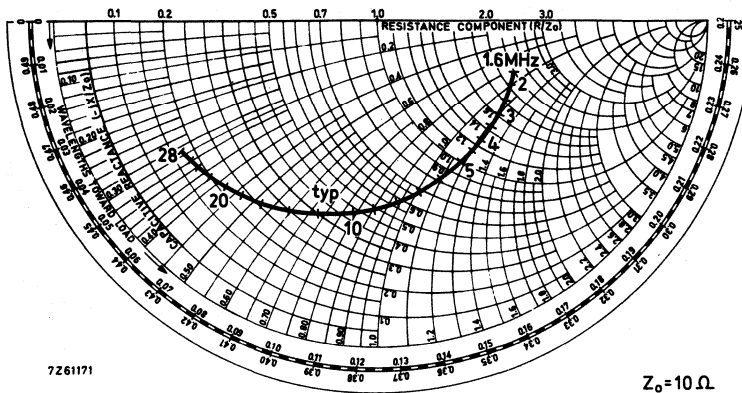
$P_L = 25 \text{ W PEP}$

$V_{CC} = 28 \text{ V}$

$I_{CZS} = 25 \text{ mA}$

$Z_L = 12.5 \Omega$

$T_h = 25 \text{ }^\circ C$



Conditions:

$$P_L = 25 \text{ W PEP}$$

$$V_{CC} = 28 \text{ V}$$

$$I_{CZS} = 25 \text{ mA}$$

$$Z_L = 12.5 \Omega$$

$$T_h = 25 \text{ }^\circ\text{C}$$

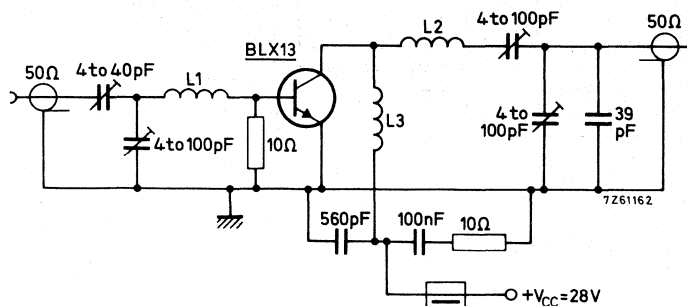
## APPLICATION INFORMATION

R.F. performance in c. w. operation (class B)

$$V_{CC} = 28 \text{ V}; T_h \text{ up to } 25 \text{ }^\circ\text{C}$$

f (MHz)	P <sub>S</sub> (W)	P <sub>L</sub> (W)	I <sub>C</sub> (A)	G <sub>p</sub> (dB)	η (%)	$\bar{z}_i$ (Ω)	$\bar{Y}_L$ (mS)
70	typ. 0.5	25	typ. 1.49	typ. 17	typ. 60	0.53-j1.4	42.5-j54

Test circuit:

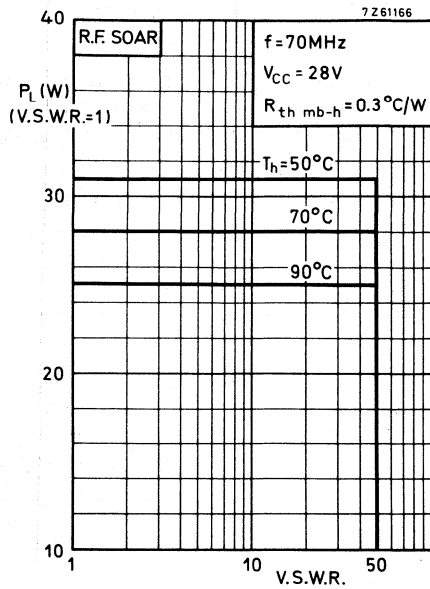
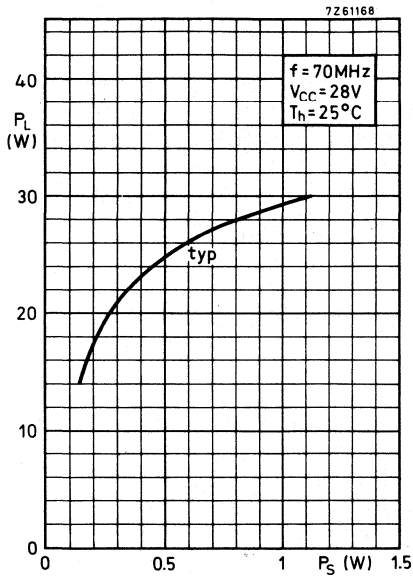
C.W.  
class B

L1 = 93 nH; 3 turns enamelled Cu wire (1.5 mm); int. diam. 10 mm; length 8 mm;  
leads 2 x 5 mm

L2 = 147 nH; 5 turns enamelled Cu wire (1.5 mm); int. diam. 9 mm; length 14 mm;  
leads 2 x 5 mm

L3 = 118 nH; 4 turns enamelled Cu wire (1.5 mm); int. diam. 9 mm; length 10.5 mm;  
leads 2 x 5 mm

L4 = FXC choke (code number 4312 020 36640)



For high voltage operation, a stabilized power supply is generally used. The graph shows the allowable output power under nominal conditions as a function of the V.S.W.R., with heat-sink temperature as parameter.



## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in transmitting amplifiers operating in the h.f. and v.h.f. bands, with a nominal supply voltage of 28 V. The transistor is specified for s.s.b. applications as linear amplifier in class-A and AB. The device is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

Matched  $h_{FE}$  groups are available on request.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

## QUICK REFERENCE DATA

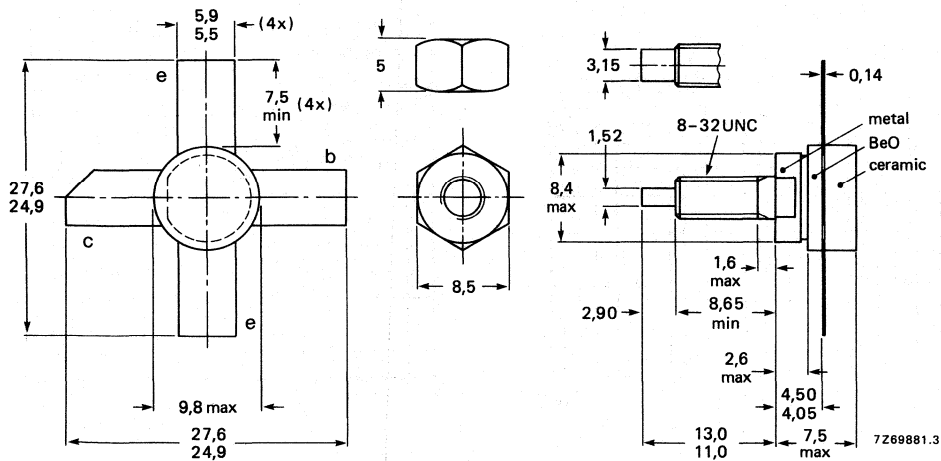
## R.F. performance

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_{dt}$ %	$I_C$ A	$d_3$ dB	$T_h$ °C
s.s.b. (class-A)	26	1,6–28	0–8 (P.E.P.)	> 20	–	1,25	< –40	70
s.s.b. (class-AB)	28	1,6–28	3–25 (P.E.P.)	typ. 21	typ. 45	typ. 1,0	typ. –30	25

## MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or  
countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open-collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	3 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	9 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	73 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

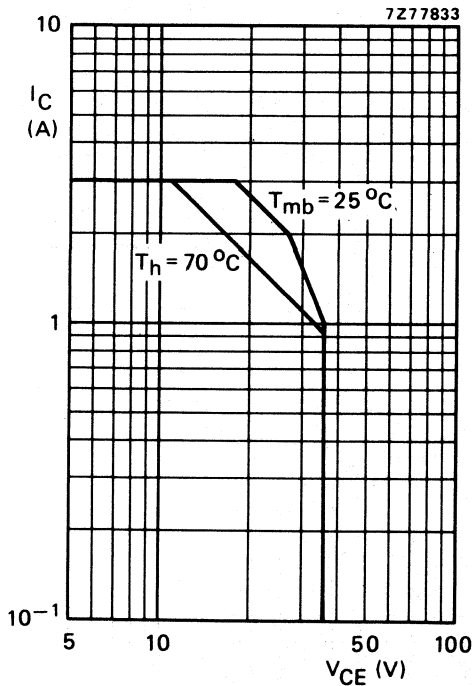


Fig. 2 D.C. SOAR.

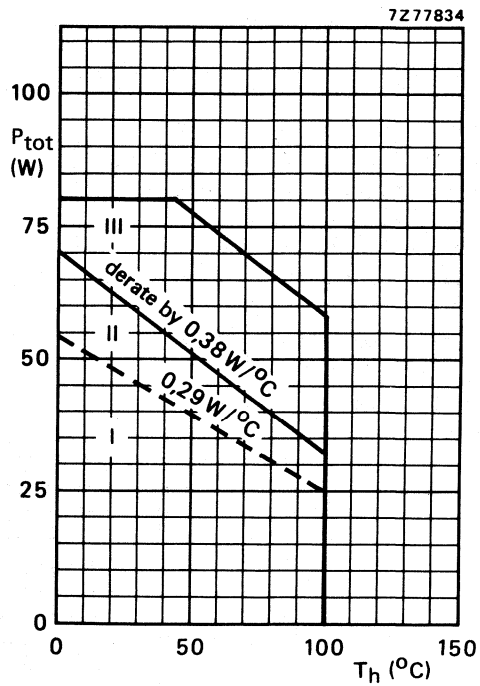


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f \geq 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operating during mismatch

**THERMAL RESISTANCE** (dissipation = 32,5 W;  $T_{mb} = 85$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	3,55 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	2,65 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,45 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 10\text{ mA}$

$V_{(BR)CES} > 65\text{ V}$

Collector-emitter breakdown voltage

open base;  $I_C = 50\text{ mA}$

$V_{(BR)CEO} > 36\text{ V}$

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0; V_{CE} = 36\text{ V}$

$I_{CES} < 4\text{ mA}$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$

open base

$E_{SBO} > 8\text{ mJ}$

$R_{BE} = 10\text{ }\Omega$

$E_{SBR} > 8\text{ mJ}$

D.C. current gain \*

$I_C = 1,25\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE}$  typ. 50  
10 to 100

D.C. current gain ratio of matched devices \*

$I_C = 1,25\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE1}/h_{FE2} < 1,2$

Collector-emitter saturation voltage \*

$I_C = 3,75\text{ A}; I_B = 0,75\text{ A}$

$V_{CEsat}$  typ. 1,5 V

Transition frequency at  $f = 100\text{ MHz}$  \*

$-I_E = 1,25\text{ A}; V_{CB} = 28\text{ V}$

$f_T$  typ. 530 MHz

$-I_E = 3,75\text{ A}; V_{CB} = 28\text{ V}$

$f_T$  typ. 530 MHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 28\text{ V}$

$C_c$  typ. 50 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$

$C_{re}$  typ. 31 pF

Collector-stud capacitance

$C_{cs}$  typ. 2 pF

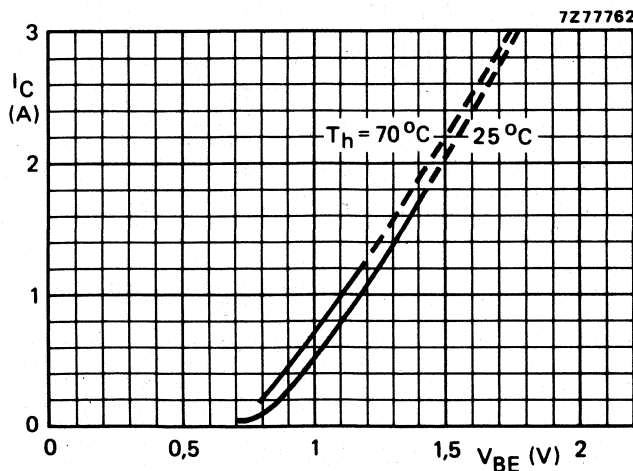


Fig. 4 Typical values;  $V_{CE} = 28\text{ V}$ .

\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

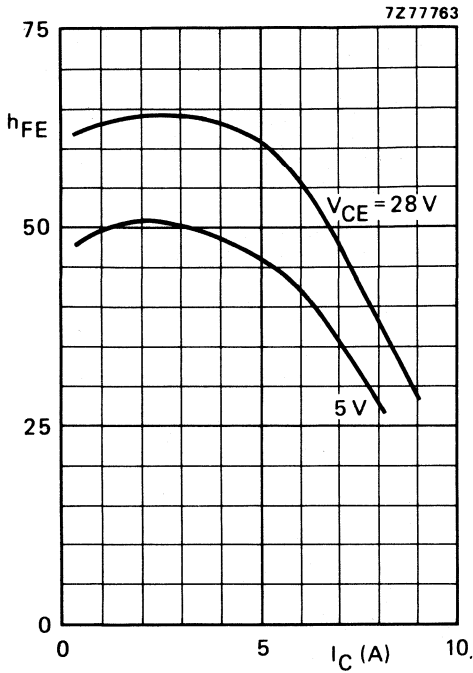


Fig. 5 Typical values;  $T_j = 25^\circ\text{C}$ .

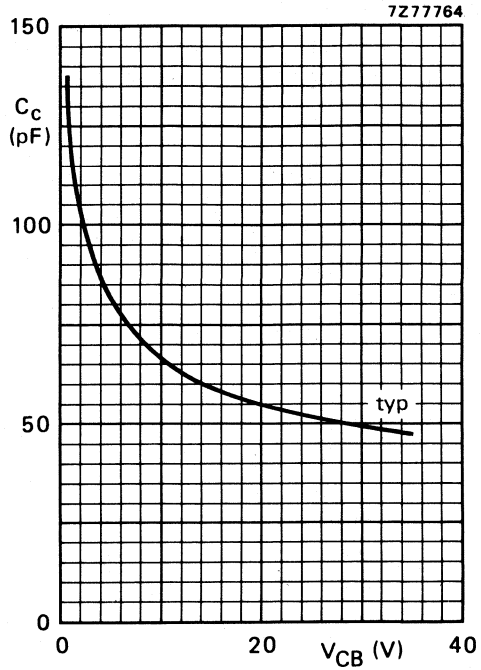


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

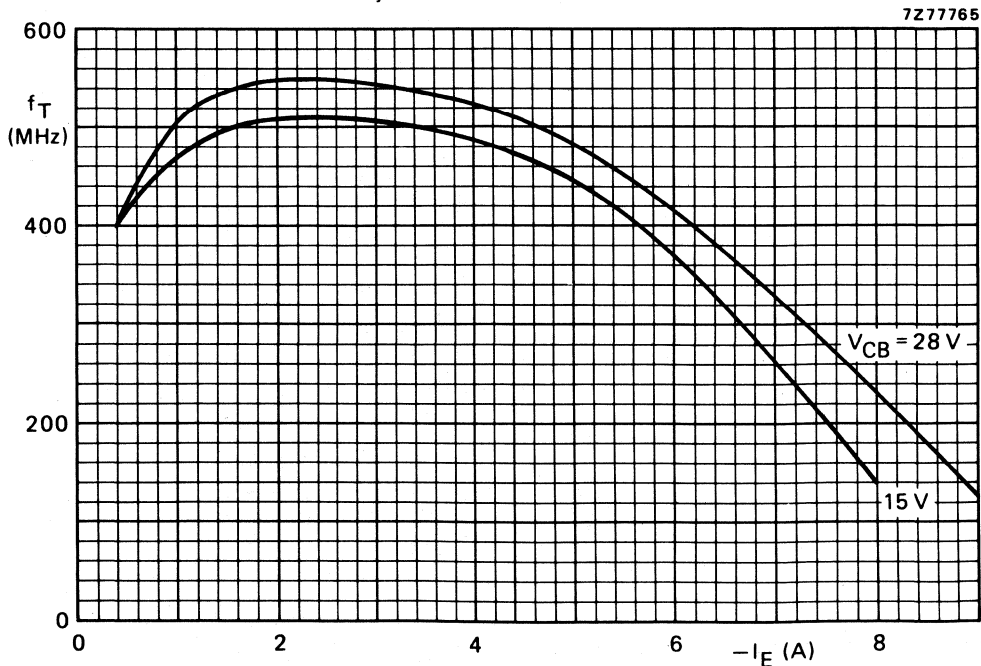


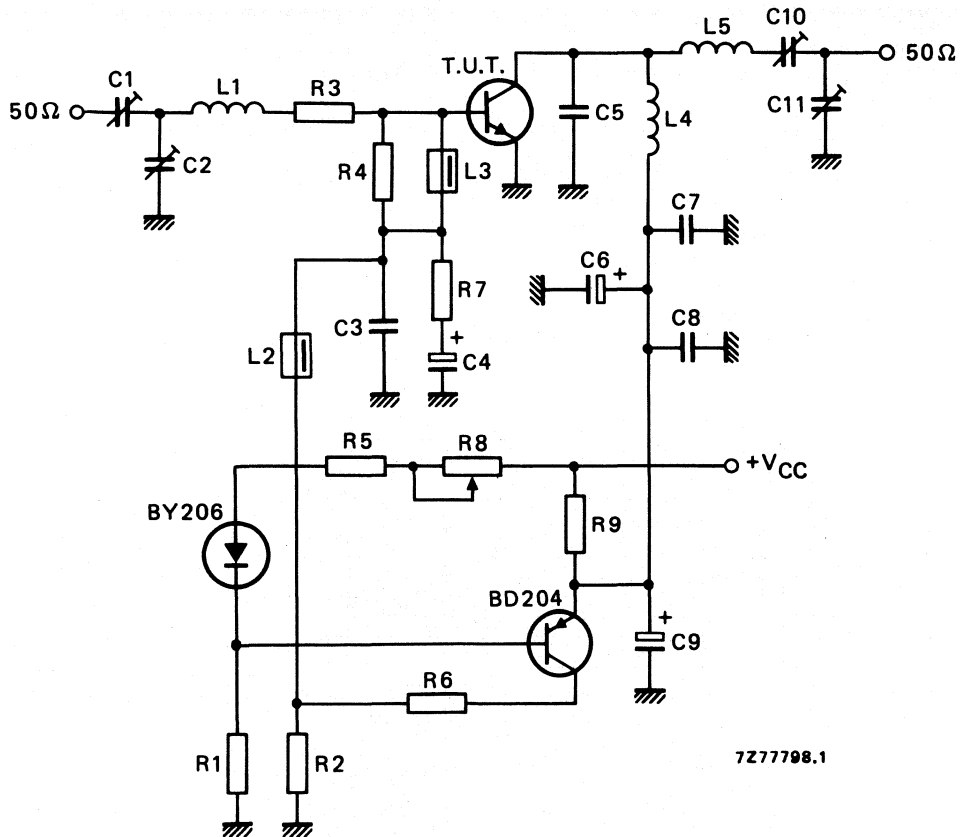
Fig. 7 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

**APPLICATION INFORMATION**

R.F. performance in s.s.b. class-A operation (linear power amplifier)

$V_{CE} = 26 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$I_C$ A	$d_3$ dB*	$d_5$ dB*	$T_h$ °C
> 8 (P.E.P.)	> 20	1,25	-40	< -40	70
typ. 10 (P.E.P.)	typ. 24	1,25	-40	< -40	25



727798.1

Fig. 8 Test circuit; s.s.b. class-A.

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

List of components in Fig. 8:

C1 = C2 = 10 to 780 pF film dielectric trimmer

C3 = 22 nF ceramic capacitor (63 V)

C4 = 47  $\mu$ F/10 V electrolytic capacitor

C5 = 56 pF ceramic capacitor (500 V)

C6 = 47  $\mu$ F/35 V electrolytic capacitor

C7 = C8 = 220 nF polyester capacitor

C9 = 10  $\mu$ F/35 V electrolytic capacitor

C10 = 10 to 210 pF film dielectric trimmer

C11 = 15 to 575 film dielectric trimmer

L1 = 3 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L2 = L3 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = 11 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 11,0 mm

L5 = 14 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 11,0 mm

R1 = 600  $\Omega$ ; parallel connection of 2 x 1,2 k $\Omega$  carbon resistors ( $\pm$  5%; 0,5 W each)

R2 = 15  $\Omega$  carbon resistor ( $\pm$  5%; 0,25 W)

R3 = 1,2  $\Omega$  parallel connection of 4 x 4,7  $\Omega$  carbon resistors ( $\pm$  5%; 0,125 W each)

R4 = 33  $\Omega$  carbon resistor ( $\pm$  5%; 0,25 W)

R5 = 18  $\Omega$  carbon resistor ( $\pm$  5%; 0,25 W)

R6 = 120  $\Omega$  wirewound resistor ( $\pm$  5%; 5,5 W)

R7 = 1  $\Omega$  carbon resistor ( $\pm$  5%; 0,125 W)

R8 = 47  $\Omega$  wirewound potentiometer (3 W)

R9 = 1,57  $\Omega$ ; parallel connection of 3 x 4,7  $\Omega$  wirewound resistors ( $\pm$  5%; 5,5 W each)

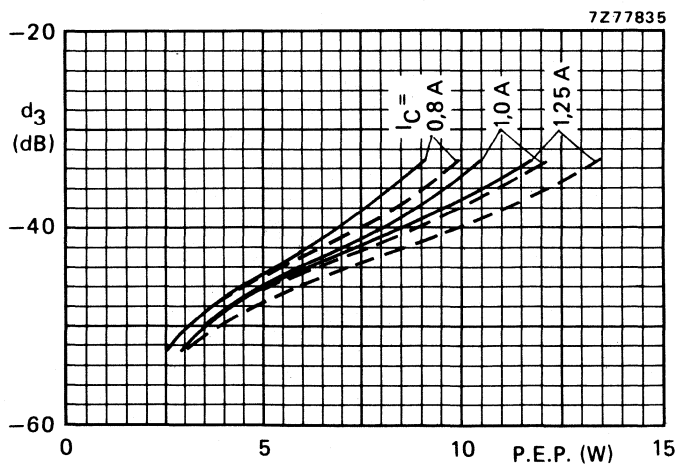


Fig. 9 Intermodulation distortion as a function of output power.  
 Typical values;  $V_{CE} = 26$  V;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz;  
 ———  $T_h = 70$  °C; - - -  $T_h = 25$  °C.

R.F. performance in s.s.b. class-AB operation (linear power amplifier)

$V_{CE} = 28 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$\eta_{dt}$ (%) at 25 W P.E.P.	$I_C$ (A)	$d_3$ dB *	$d_5$ dB *	$I_{C(ZS)}$ mA	$T_h$ $^{\circ}\text{C}$
3 to 25 (P.E.P.)	typ. 21	typ. 45	typ. 1,0	typ. -30	< -30	25	25
3 to 22 (P.E.P.)	typ. 21	-	-	typ. -30	< -30	25	70

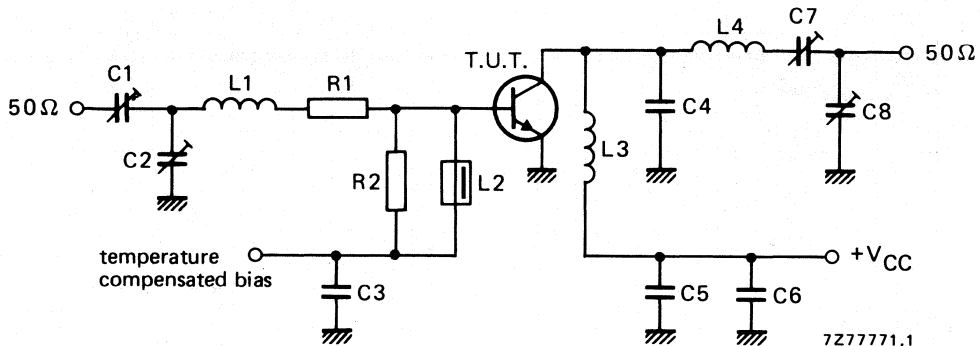


Fig. 10 Test circuit; s.s.b. class-AB.

List of components:

$C1 = C2 = 10$  to  $780 \text{ pF}$  film dielectric trimmer

$C3 = C5 = C6 = 220 \text{ nF}$  polyester capacitor

$C4 = 56 \text{ pF}$  ceramic capacitor (500 V)

$C7 = C8 = 15$  to  $575 \text{ pF}$  film dielectric trimmer

$L1 = 4$  turns closely wound enamelled Cu wire (1,6 mm); int. dia. 7,0 mm; leads  $2 \times 5 \text{ mm}$

$L2 =$  Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

$L3 = 4$  turns enamelled Cu wire (1,6 mm); int. dia. 10 mm; length 9,4 mm; leads  $2 \times 5 \text{ mm}$

$L4 = 7$  turns enamelled Cu wire (1,6 mm); int. dia. 12 mm; length 17,2 mm; leads  $2 \times 5 \text{ mm}$

$R1 = 1,2 \Omega$ ; parallel connection of  $4 \times 4,7 \Omega$  carbon resistors

$R2 = 39 \Omega$  carbon resistor

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

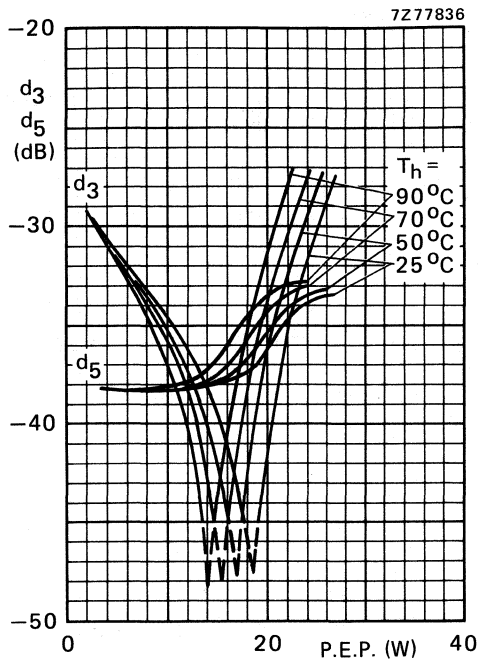


Fig. 11 Intermodulation distortion as a function of output power. \*

Conditions for Fig. 11:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 25 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ; typical values.

Conditions for Fig. 12:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 25 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_h = 25^\circ\text{C}$ ; typical values.

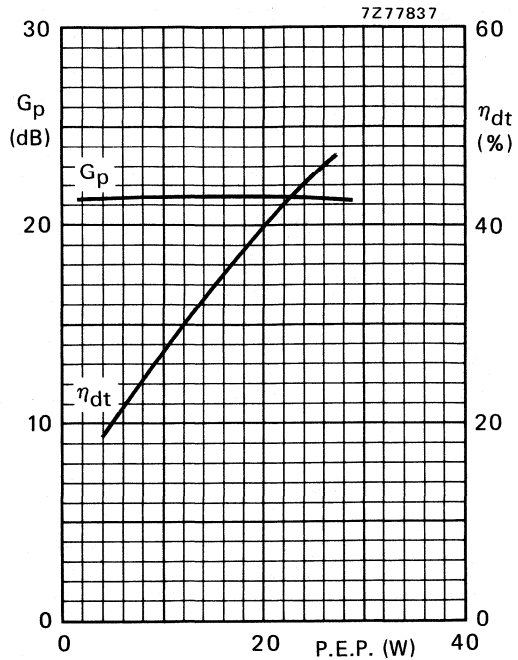


Fig. 12 Double-tone efficiency and power gain as a function of output power.

\* See note on previous page.



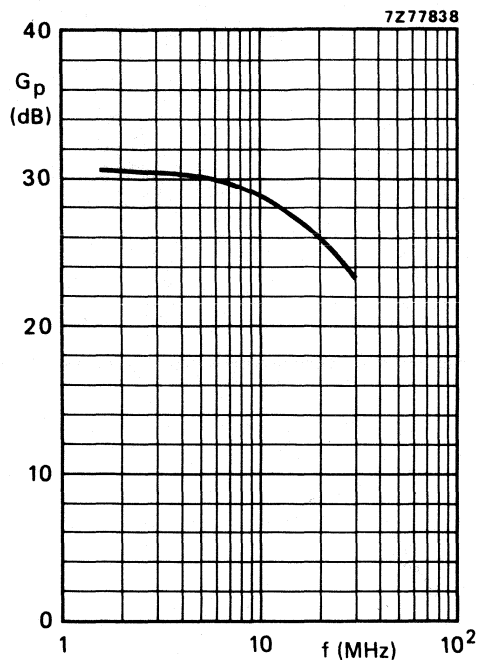


Fig. 13 Power gain as a function of frequency.

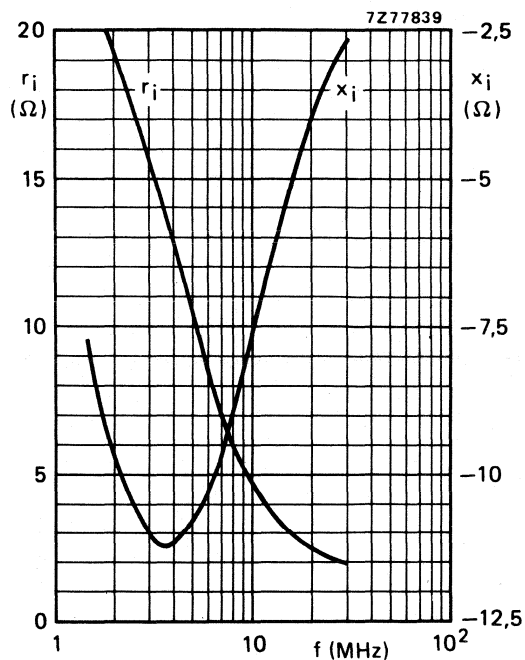


Fig. 14 Input impedance (series components) as a function of frequency.

Figs 13 and 14 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

**Conditions:**

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 25 \text{ mA}$ ;  $P_L = 25 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 12 \text{ } \Omega$ .

**Ruggedness in s.s.b. operation**

The BLX13C is capable of withstanding a load mismatch (VSWR = 50) under the following conditions:  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $V_{CE} = 28 \text{ V}$ ;  $T_h = 70 \text{ }^\circ\text{C}$  and  $P_L = 30 \text{ W (P.E.P.)}$ .



## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in class-A, AB and B operated transmitting equipment in the h.f. and v.h.f. band.

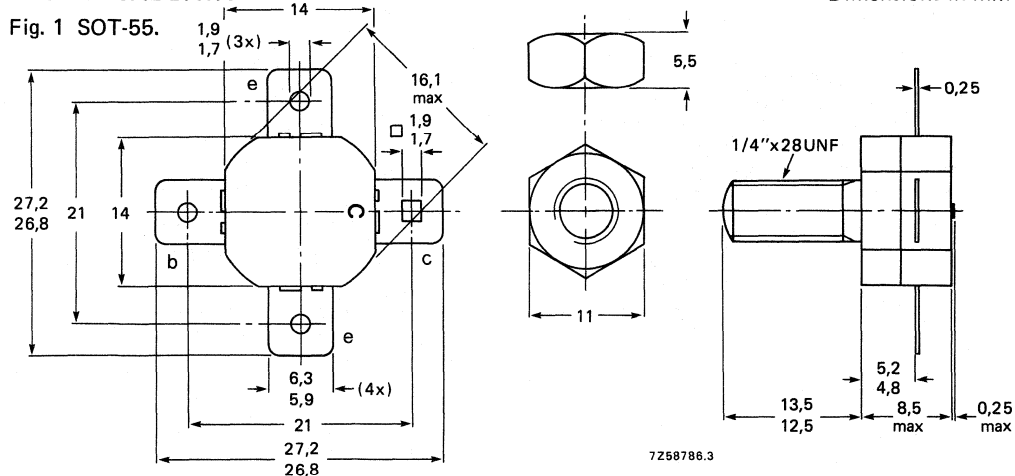
- rated for 50 W P.E.P. at 1,6 MHz to 28 MHz (intermodulation distortion better than  $-30$  dB); full load mismatch permissible at stud temperatures up to  $70$  °C
- rated at 50 W for frequencies up to 70 MHz in c.w. operation
- supply voltage 28 V
- plastic stripline package

### QUICK REFERENCE DATA

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$d_3$ dB	$I_C(ZS)$ A
s.s.b. (class-A)	28	1,6 to 28	15 (P.E.P.)	$> 13$	typ. $-40$	2,0
s.s.b. (class-AB)	28	1,6 to 28	7,5-50 (P.E.P.)	$> 13$	$< -30$	0,1
c.w. (class-B)	28	70	50	$> 7,5$		
c.w. (class-B)	28	30	50	typ. 16		

### MECHANICAL DATA

Fig. 1 SOT-55.



Torque on nut: min. 2,3 Nm  
(23 kg cm)  
max. 2,7 Nm  
(27 kg cm)

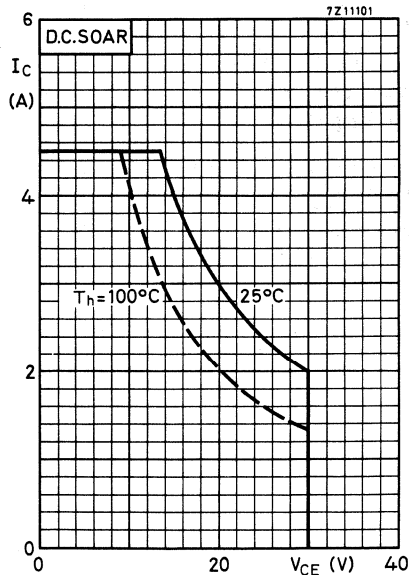
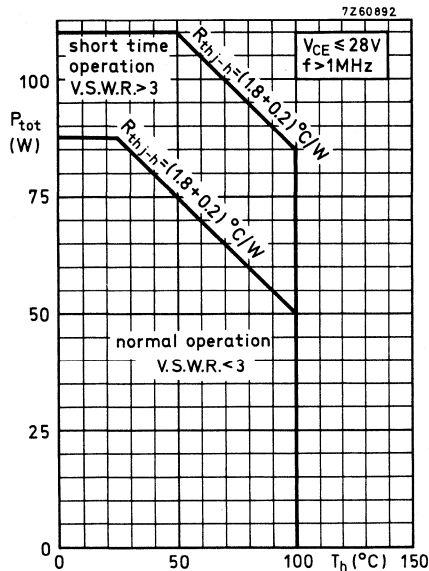
Diameter of clearance hole in heatsink: max. 6,4 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer  
or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	85 V
Collector-emitter voltage ( $R_{BE} = 10 \Omega$ ) peak value	$V_{CERM}$	max.	85 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4.0 V
Collector current (average)	$I_{CAV}$	max.	4.0 A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	12 A
Total power dissipation up to $T_h = 25^\circ C$ $f > 1$ MHz	$P_{tot}$	max.	88 W



Storage temperature	$T_{stg}$	-65 to +200 °C
Operating junction temperature	$T_j$	max. +200 °C

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th j-mb}$	=	1.8 K/W
From mounting base to heatsink	$R_{th mb-h}$	=	0.2 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ Collector-base breakdown voltage  
open emitter;  $I_C = 25\text{ mA}$  $V_{(BR)CBO} > 85\text{ V}$ Collector-emitter breakdown voltage  
 $R_{BE} = 10\ \Omega$ ;  $I_C = 25\text{ mA}$   
open base;  $I_C = 50\text{ mA}$  $V_{(BR)CER} > 85\text{ V}$  $V_{(BR)CEO} > 36\text{ V}$ Emitter-base breakdown voltage  
open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4,0\text{ V}$ Collector-emitter saturation voltage  
 $I_C = 0,7\text{ A}$ ;  $I_B = 0,14\text{ A}$  $V_{CEsat} < 1,0\text{ V}$ Second breakdown energy;  $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$   
open base $E_{SBO} > 8\text{ mJ}$  $R_{BE} = 33\ \Omega$  $E_{SBR} > 8\text{ mJ}$ 

D.C. current gain

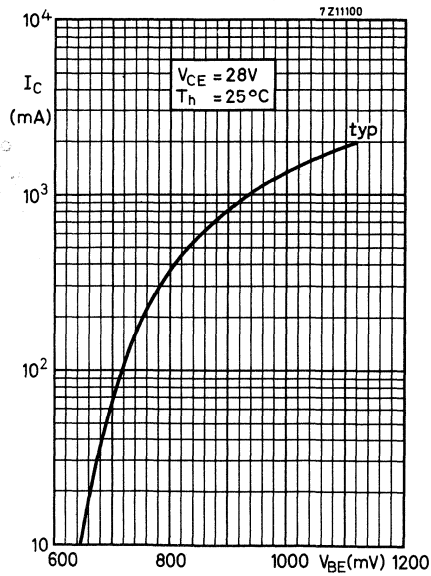
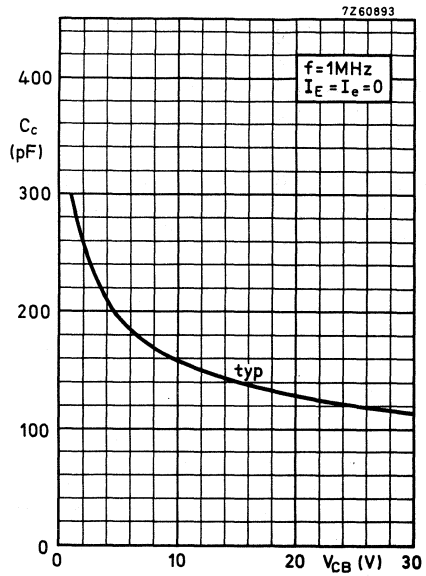
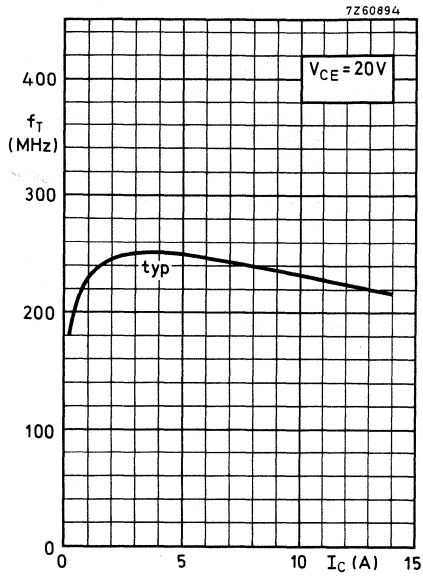
 $I_C = 1,4\text{ A}$ ;  $V_{CE} = 6\text{ V}$  $h_{FE} \quad 15\text{ to }100$ 

Transition frequency

 $I_C = 3,0\text{ A}$ ;  $V_{CE} = 20\text{ V}$  $f_T \quad \text{typ. } 250\text{ MHz}$ Collector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0$ ;  $V_{CB} = 30\text{ V}$  $C_c \quad \text{typ. } 115\text{ pF}$   
 $< 125\text{ pF}$ Feedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}$ ;  $V_{CE} = 30\text{ V}$  $C_{re} \quad \text{typ. } 90\text{ pF}$ 

Collector-stud capacitance

 $C_{cs} \quad \text{typ. } 3,5\text{ pF}$



R.F. performance in s.s.b. class-AB operation (linear power amplifier)

$$V_{CE} = 28 \text{ V}; f_1 = 28,000 \text{ MHz}; f_2 = 28,001 \text{ MHz}$$

output power W	Gp dB	$\eta_{dt}$ %	$I_C$ A	$d_3^*$ dB	$d_5^*$ dB	$I_C(ZS)$ A	$T_h$ °C
7,5 to 50 (P.E.P.)	> 13	> 35	< 2,55	< -30	< -30	0,1	25

At temperatures up to 90 °C the output power relative to that at 25 °C is diminished by -40 mW/K.

The transistor is designed to withstand a full load mismatch operating under 50 W P.E.P. at  $V_{CE} = 28 \text{ V}$  and  $T_h = 70 \text{ °C}$ .

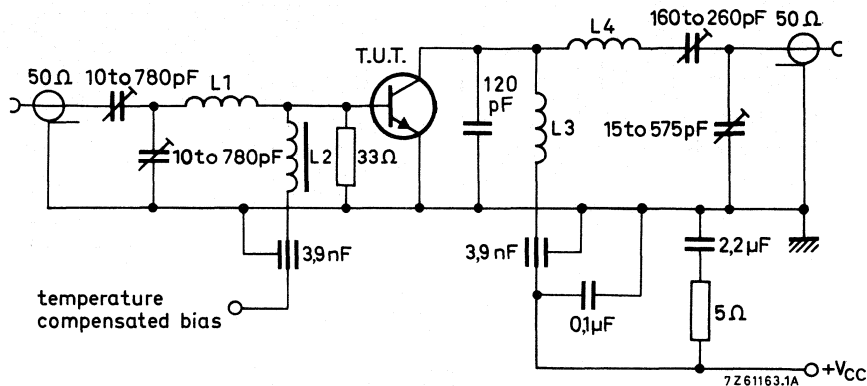


Fig. 7 Test circuit; s.s.b. class-AB.

List of components:

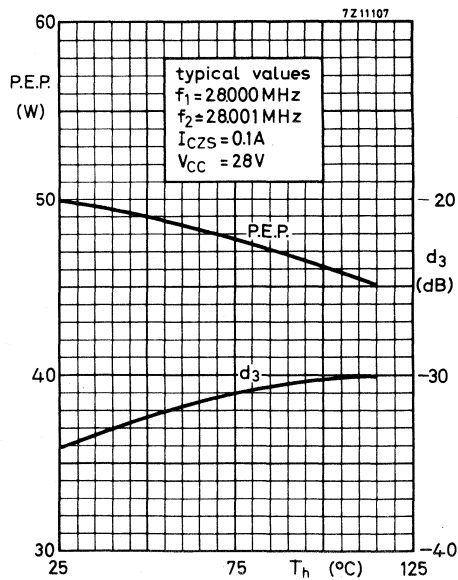
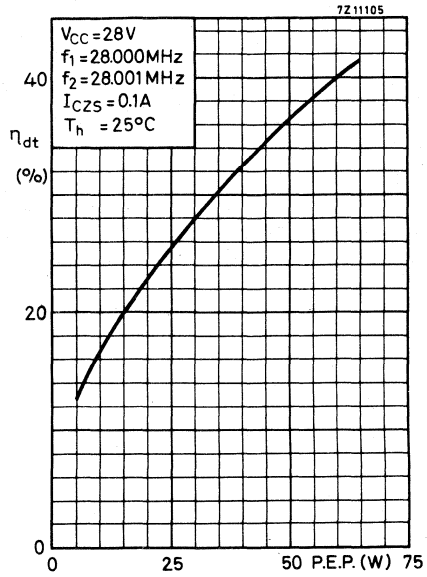
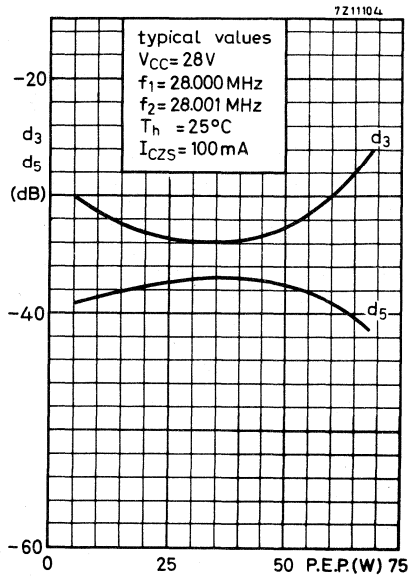
L1 = 3 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 7,0 mm; leads 50 mm (total)

L2 = 7 turns enamelled Cu wire (0,7 mm) on 3H1 toroid; 60 μH (cat. no. of 3H1 4322 020 36620)

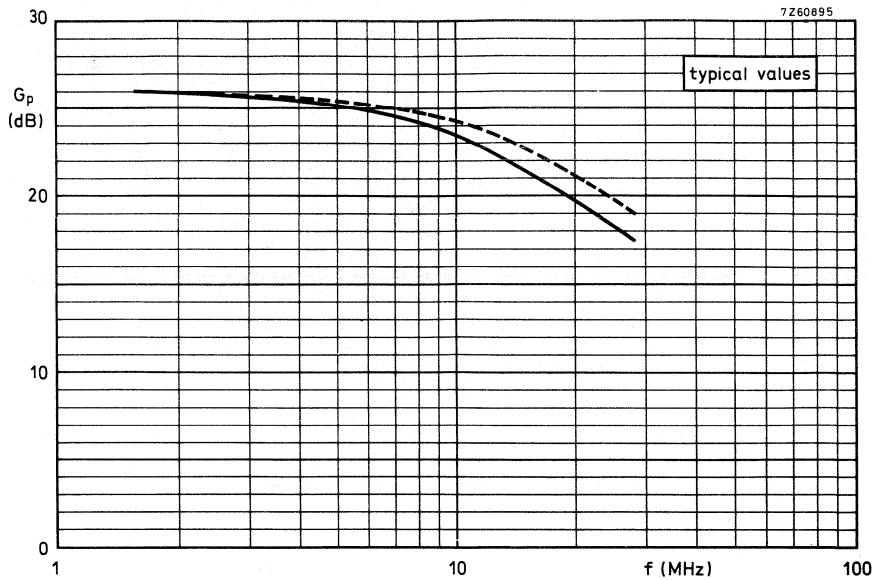
L3 = 4 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 10 mm

L4 = 7 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 12 mm

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.





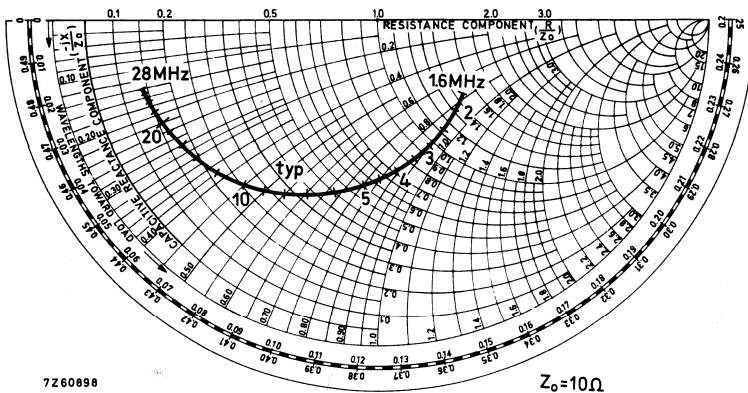
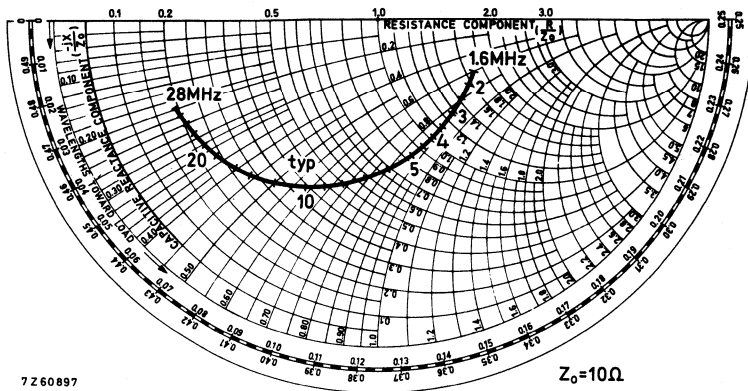


S.S.B. class AB operation

$$\begin{aligned}
 P_L &= 50 \text{ W PEP} \\
 V_{CC} &= 28 \text{ V} \\
 I_C &= 100 \text{ mA} \\
 Z_L &= 6.25 \Omega \\
 T_h &= 25 \text{ }^\circ\text{C}
 \end{aligned}$$

The drawn curve holds for an unneutralized amplifier.

The dashed curve holds for a push-pull amplifier with cross neutralization.  
Collector-base neutralizing capacitor: 82 pF



S.S.B. class AB operation

- $P_L = 50 \text{ W PEP}$
- $V_{CC} = 28 \text{ V}$
- $I_C = 100 \text{ mA}$
- $Z_L = 6.25 \Omega$
- $T_h = 25 \text{ }^\circ\text{C}$

The upper graph holds for a push-pull amplifier with cross neutralization.  
Collector-base neutralizing capacitor: 82 pF

The lower graph holds for an unneutralized amplifier.

APPLICATION INFORMATION (continued)

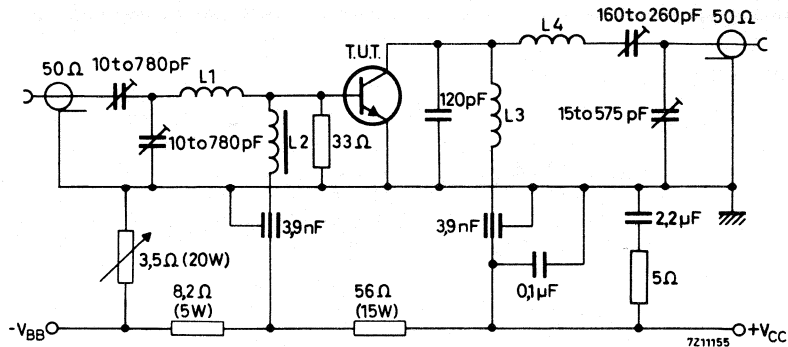
R.F. performance in s.s.b. operation (linear power amplifier)

$V_{CC} = 28\text{ V}$ ;  $T_h$  up to  $25\text{ }^\circ\text{C}$   
 $f_1 = 28,000\text{ MHz}$ ;  $f_2 = 28,001\text{ MHz}$

output power (W)	$G_p$ (dB)	$d_3$ (dB) <sup>1)</sup>	$d_5$ (dB) <sup>1)</sup>	$I_C$ (A)	Class
15 PEP	> 13	typ. -40	typ. -45	2,0	A

Test circuit:

**S.S.B. class-A**

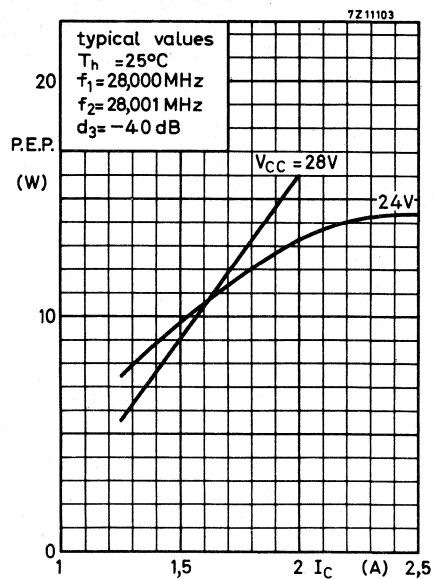
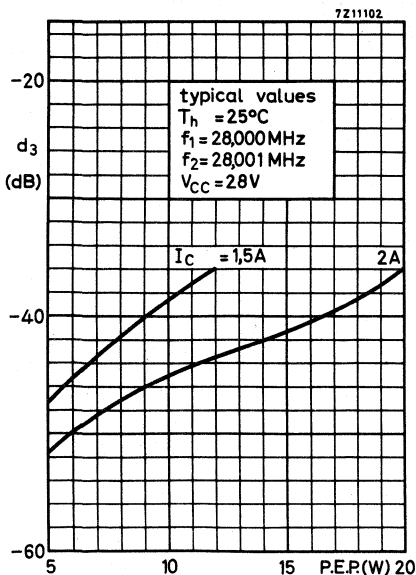


L1 = 3 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 7 mm leads 50 mm totally

L2 = 7 turns enamelled Cu wire (0,7 mm) on 3H1 toroid; 60  $\mu\text{H}$  (code number of 3H1: 4322 020 36620)

L3 = 4 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 10 mm

L4 = 7 turns enamelled Cu wire (1,5 mm); winding pitch 2,5 mm; int. dia. 12 mm



## APPLICATION INFORMATION

R. F. performance in c. w. operation (class B)

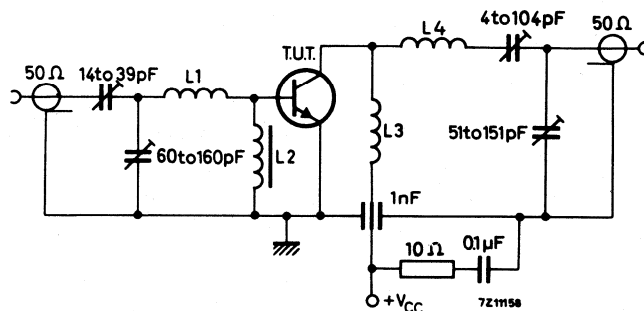
$V_{CC} = 28 \text{ V}$ ;  $T_h$  up to  $25 \text{ }^\circ\text{C}$

$f$ (MHz)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
70	< 8.9	50	< 3.25	> 7.5	> 55	$1.0 + j0.2$	$120 - j75$
50	typ. 4	50	typ. 3.25	typ. 11	typ. 55	-	-
30	typ. 1.2	50	typ. 3.25	typ. 16	typ. 55	-	-

At temperatures up to  $90 \text{ }^\circ\text{C}$  the output power relative to that at  $25 \text{ }^\circ\text{C}$  is diminished by a factor  $\sim 40 \text{ mW/K}$

Test circuit :

**C.W.**  
**70 MHz**

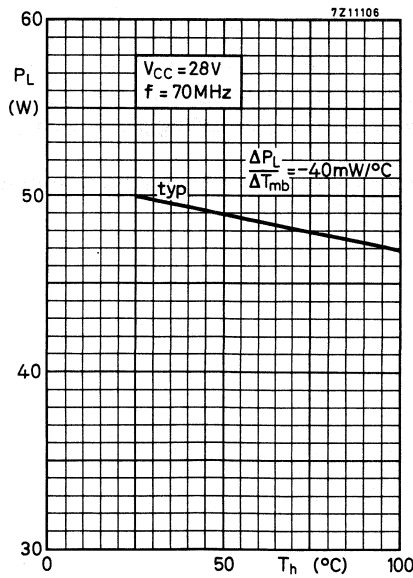
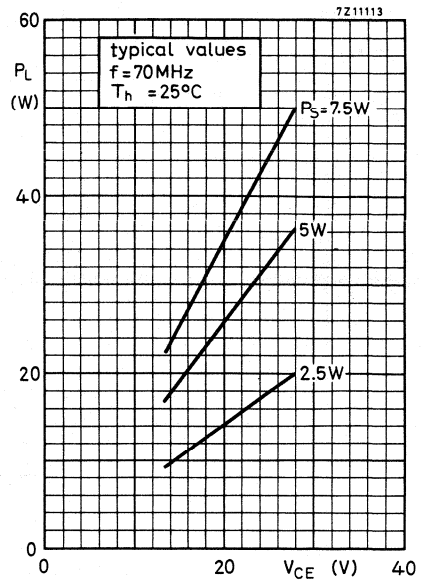
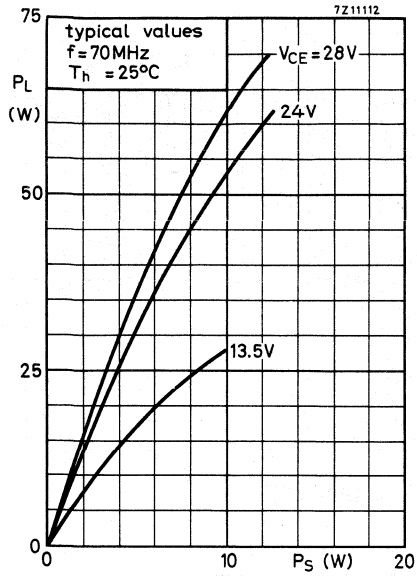


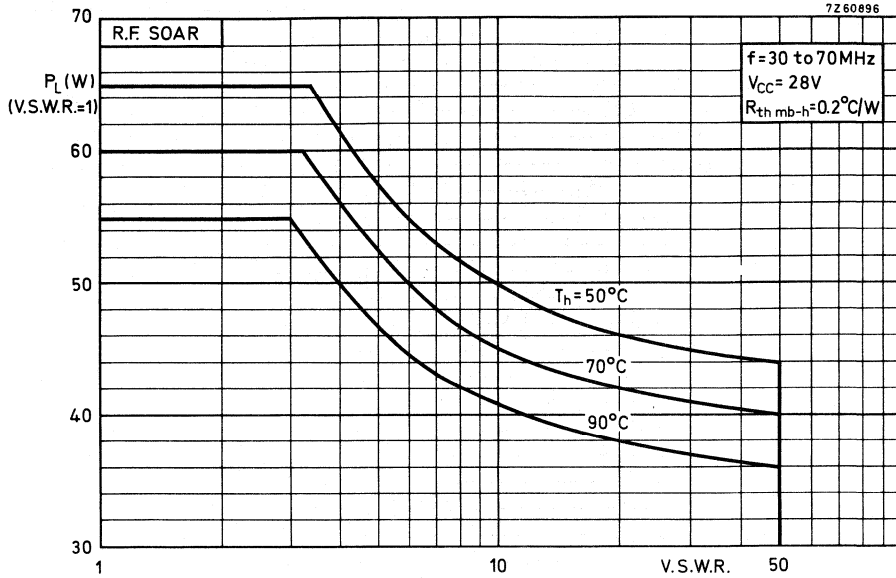
L1 = 60 mm straight enamelled Cu wire (1.5 mm); 9 mm above chassis

L2 = FXC choke coil (code number 4322 020 36640)

L3 = 2 turns enamelled Cu wire (1.5 mm); winding pitch 2 mm; internal diam. 10 mm;  
leads 55 mm totally

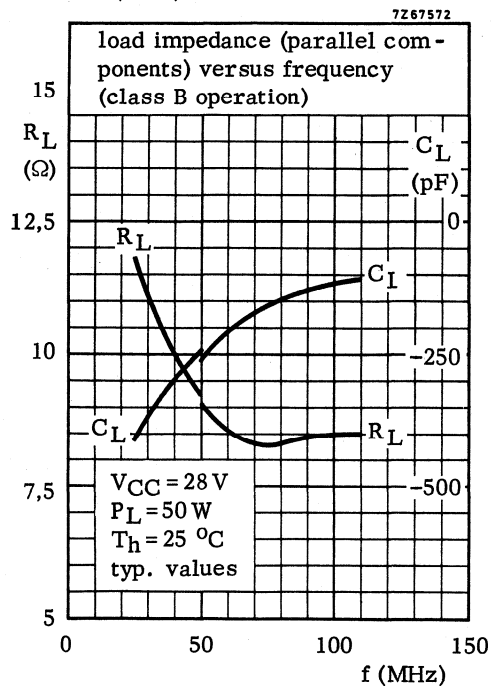
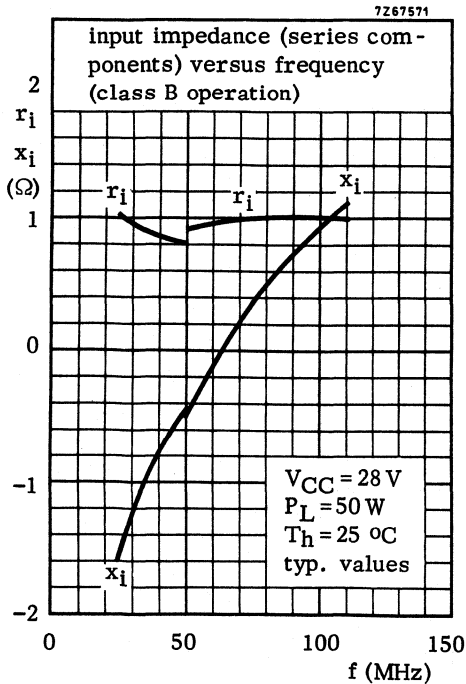
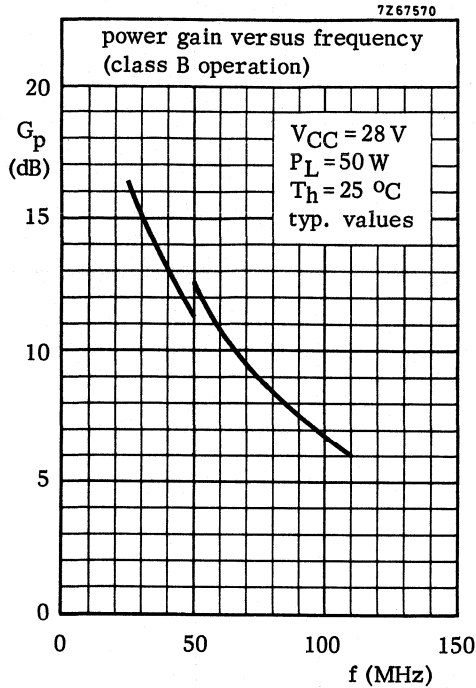
L4 = 3 turns enamelled Cu wire (1.5 mm); winding pitch 2.5 mm; internal diam. 10 mm;  
leads 50 mm totally





For high voltage operation, a stabilized power supply generally used.  
 The graph shows the allowable output power under nominal conditions as a function of the V.S.W.R., with heatsink temperature as parameter.

**OPERATING NOTE** Below 50 MHz a base-emitter resistor of  $6,8 \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.







## H.F./V.H.F. POWER TRANSISTOR

Silicon n-p-n power transistor for use in industrial and military s.s.b. and c.w. equipment operating in the h.f. and v.h.f. band:

- rated for 150 W P.E.P. at 1,6 MHz to 28 MHz  
(intermodulation distortion better than 30 dB down)
- rated at 150 W output power for frequencies up to 108 MHz in c.w. operation
- supply voltage up to 50 V
- plastic encapsulated stripline package
- delivered in matched  $h_{FE}$  groups

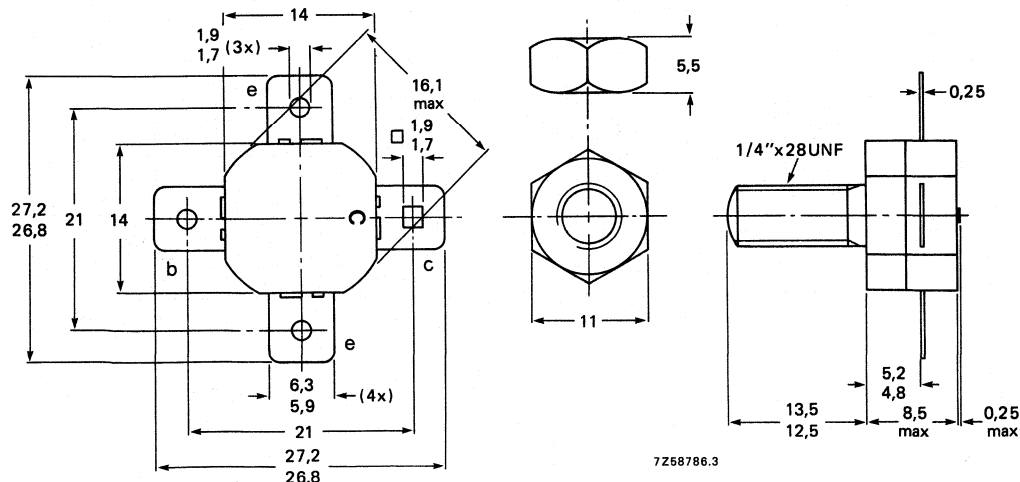
### QUICK REFERENCE DATA

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$d_3$ dB	$I_{C(ZS)}$ A
s.s.b. (class-AB)	50	1,6 to 28	20 to 150 (P.E.P.)	> 14	< -30	0,10
s.s.b. (class-A)	40	1,6 to 28	typ. 30 (P.E.P.)	> 14	< -40	2,5
c.w. (class-B)	50	70	150	> 10	—	—
c.w. (class-B)	50	108	150	typ. 7,4	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-55.



When locking is required an adhesive is preferred instead of a lock washer.

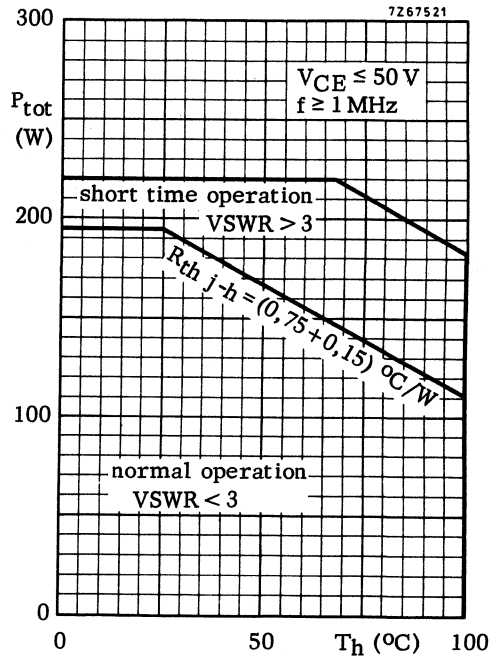
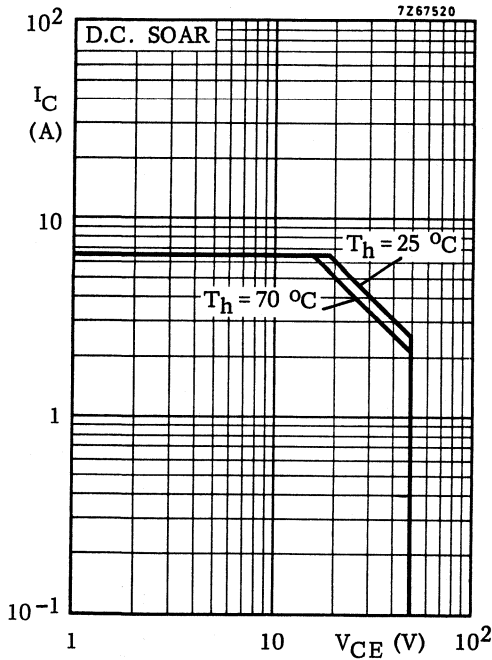
Torque on nut: min. 2,3 Nm  
(23 kg cm)  
max. 2,7 Nm  
(27 kg cm)

Diameter of clearance hole in heatsink: max. 6,4 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer  
or countersink either end of hole.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	110 V
Collector-emitter voltage ( $R_{BE} = 10\Omega$ ) peak value	$V_{CERM}$	max.	110 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	53 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4,0 V
Collector current (average)	$I_{C(AV)}$	max.	6,5 A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	20 A



Storage temperature  
Junction temperature

$T_{stg}$	-65 to +200 °C
$T_j$	max. 200 °C

**THERMAL RESISTANCE**

From junction to mounting base  
From mounting base to heatsink

$R_{th j-mb}$	=	0,75 K/W
$R_{th mb-h}$	=	0,15 K/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage open emitter ; $I_C = 100\text{ mA}$	$V_{(BR)CBO}$	>	110	V
Collector-emitter voltage $R_{BE} = 5\ \Omega$ ; $I_C = 100\text{ mA}$	$V_{(BR)CER}$	>	110	V
Collector-emitter voltage open base ; $I_C = 100\text{ mA}$	$V_{(BR)CEO}$	>	53	V
Emitter-base voltage open collector; $I_E = 20\text{ mA}$	$V_{(BR)EBO}$	>	4,0	V

## Transient energy

 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ 

open base	E	>	12,5	ms
$-V_{BE} = 1,5\text{ V}$ ; $R_{BE} = 33\ \Omega$	E	>	12,5	ms

## D.C. current gain

$I_C = 1,4\text{ A}$ ; $V_{CE} = 6\text{ V}$	$h_{FE}$		15 to 50	
----------------------------------------------	----------	--	----------	--

## D.C. current gain ratio of matched devices

$I_C = 1,4\text{ A}$ ; $V_{CE} = 6\text{ V}$	$h_{FE1}/h_{FE2}$	<	1,2	
----------------------------------------------	-------------------	---	-----	--

## Transition frequency

$I_C = 6,0\text{ A}$ ; $V_{CE} = 35\text{ V}$	$f_T$	typ.	275	MHz
-----------------------------------------------	-------	------	-----	-----

Collector capacitance at  $f = 1\text{ MHz}$ 

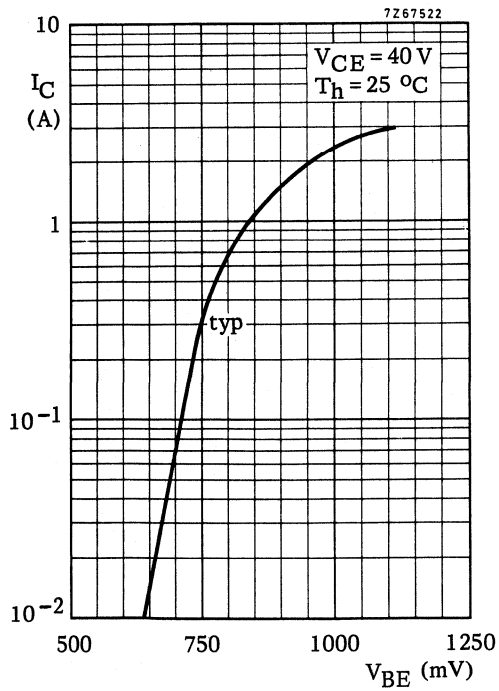
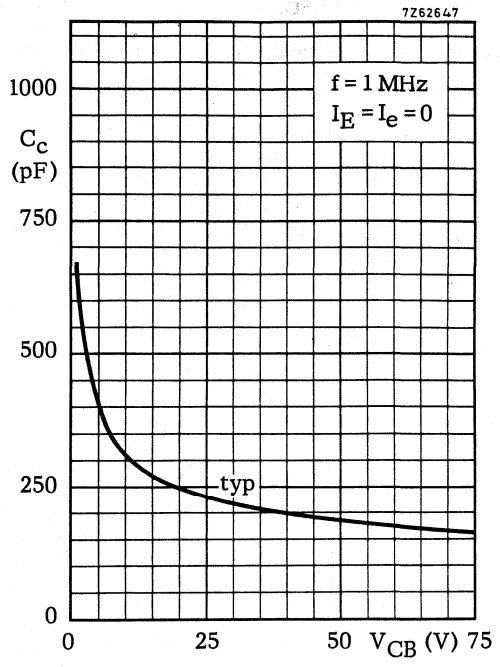
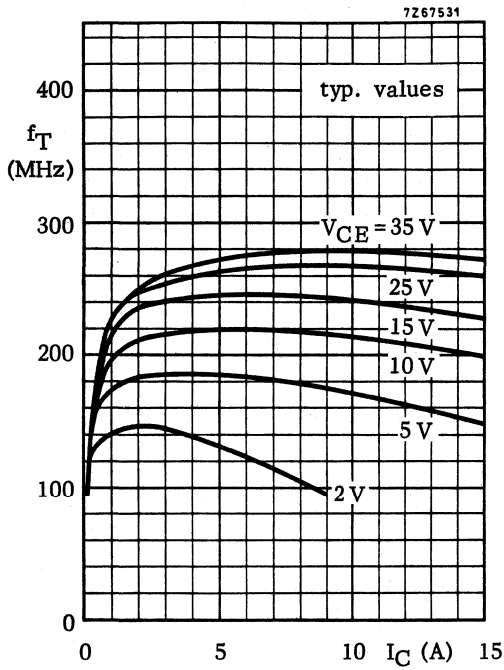
$I_E = I_e = 0$ ; $V_{CB} = 50\text{ V}$	$C_c$	typ.	185	pF
		<	220	pF

Feedback capacitance at  $f = 1\text{ MHz}$ 

$I_C = 150\text{ mA}$ ; $V_{CE} = 50\text{ V}$	$C_{re}$	typ.	115	pF
------------------------------------------------	----------	------	-----	----

## Collector-stud capacitance

	$C_{cs}$	typ.	3,5	pF
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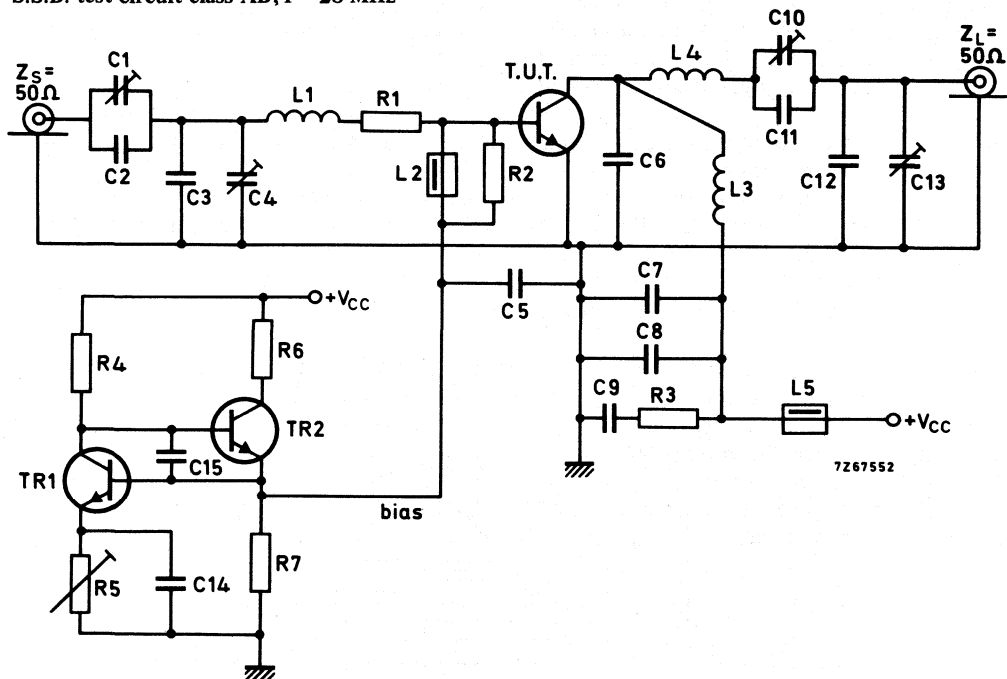


## APPLICATION INFORMATION

R.F. performance in s.s.b. operation (linear power amplifier)

 $T_h$  up to 25 °C $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz

output power (W)	$G_p$ (dB)	$\eta_{dt}$ (%)	$d_3$ (dB) 1)	$d_5$ (dB) 1)	$I_{CZS}$ (A)	$I_C$ (A)	$V_{CE}$ (V)	Class
20 to 150 (PEP)	> 14	> 37,5	< -30	< -30	0,10	< 4	50	AB
typ. 30 (PEP)	> 14	typ. 15	< -40	< -40	2,5	-	40	A

S.S.B. test circuit class AB;  $f = 28$  MHz

List of components: see page 6.

1) Stated figures are maxima encountered at any driving level between the specified values of PEP and are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope power these figures should be increased by 6 dB.

## APPLICATION INFORMATION (continued)

List of components:

Tr1 = BD135

Tr2 = BD228

C1 = C10 = 100 pF air dielectric capacitor (single insulated rotor type)  
 C2 = C6 = 27 pF ceramic capacitor  
 C3 = 180 pF ceramic capacitor  
 C4 = C13 = 100 pF air dielectric capacitor (single non-insulated rotor)  
 C5 = C7 = 3,9 nF polyester capacitor ( $\pm 10\%$ )  
 C8 = C14 = C15 = 100 nF polyester capacitor ( $\pm 10\%$ )  
 C9 = 2,2  $\mu$ F moulded metallized polyester capacitor  
 C11 = 68 pF ceramic capacitor  
 C12 = 220 pF ceramic capacitor

L1 = 88 nH; 3 turns Cu wire (1,0 mm); internal diameter 9 mm; coil length 6,1 mm; leads 2 x 5 mm

L2 = L5 = ferroxcube bead, grade 3B (code number 4312 020 36640)

L3 = 180 nH; 4 turns enamelled Cu wire (1,5 mm); internal diameter 12 mm; coil length 9,9 mm; leads 2 x 10 mm

L4 = 350 nH; 7 turns enamelled Cu wire (1,5 mm); internal diameter 12 mm; coil length 19,1 mm; leads 2 x 10 mm

R1 = 0,66  $\Omega$  parallel connection of 5 x 3,3  $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,5 W each)

R2 = 27  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)

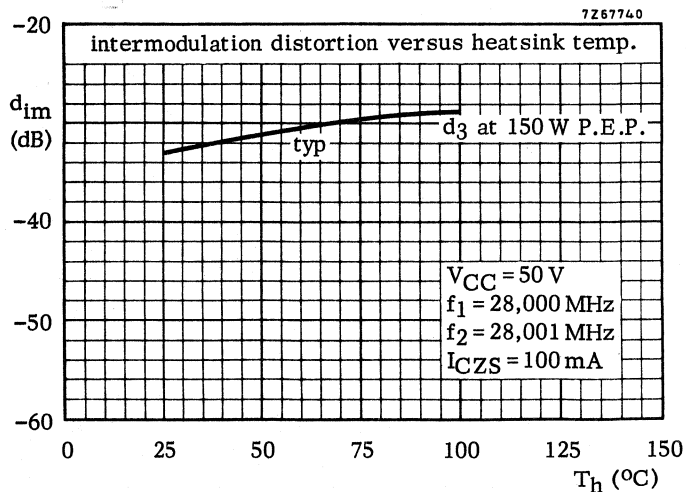
R3 = 4,7  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)

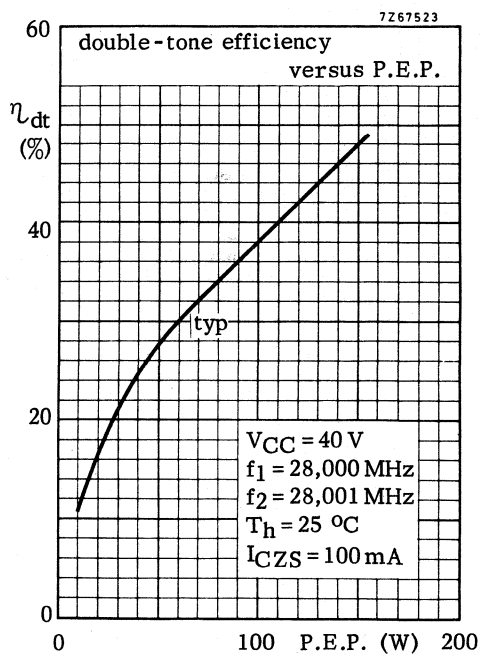
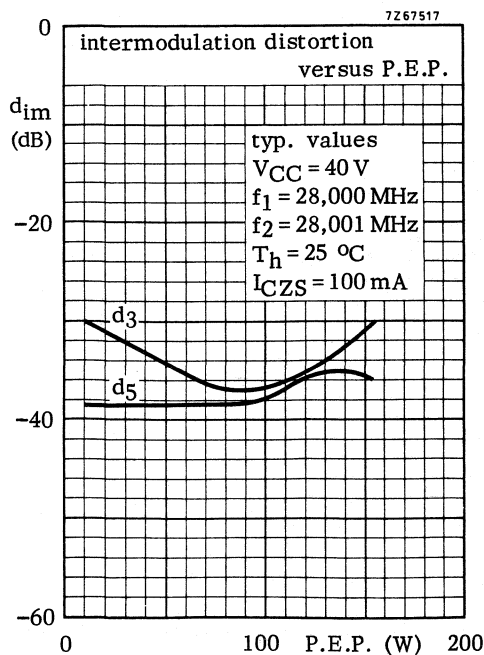
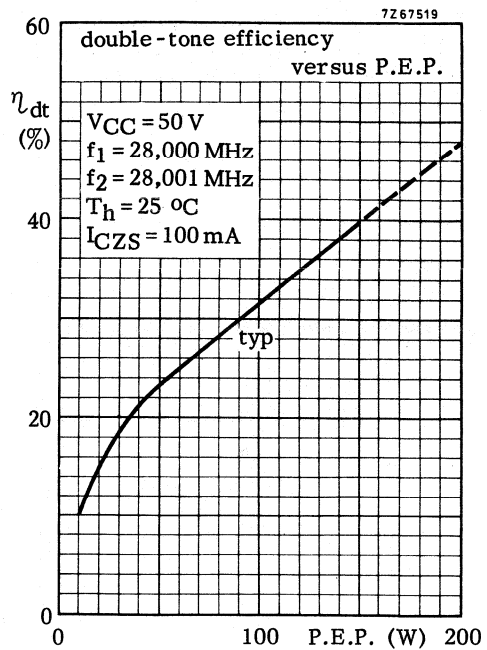
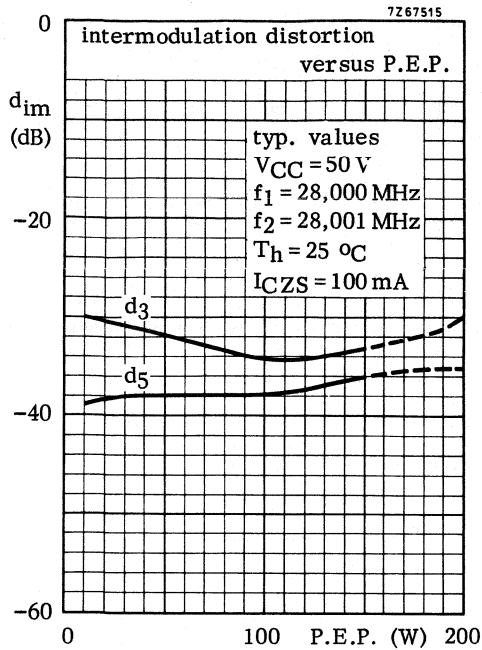
R4 = 5,6 k $\Omega$  carbon resistor ( $\pm 5\%$ ; 1 W)

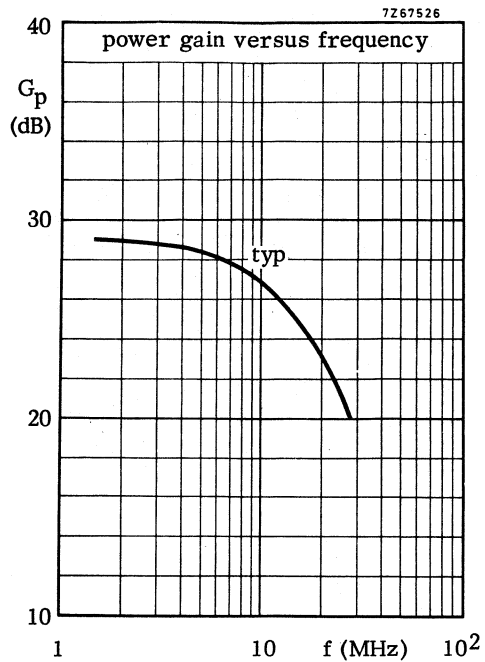
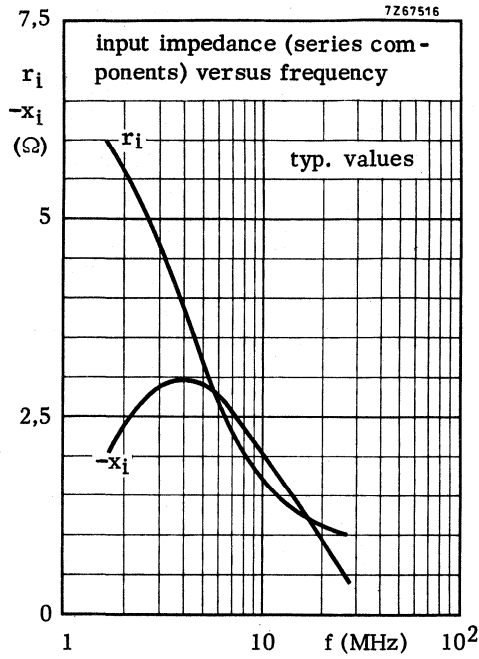
R5 = 15  $\Omega$  wire-wound potentiometer (3W)

R6 = 157  $\Omega$  parallel connection of 3 x 470  $\Omega$  wire-wound resistors (5,5W each)

R7 = 68  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)





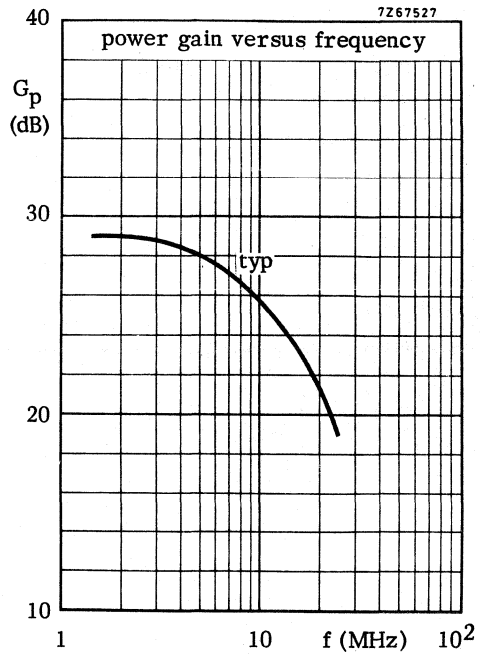
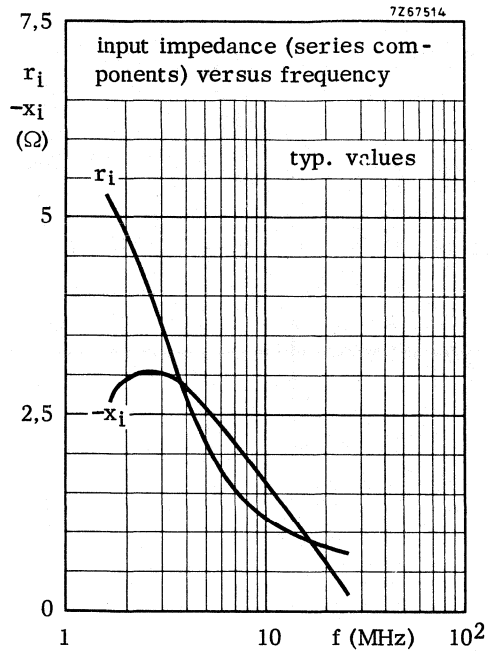


S.S.B. class AB operation

- $P_L = 150 \text{ W (PEP)}$   
 $V_{CC} = 50 \text{ V}$   
 $I_{CZS} = 100 \text{ mA}$   
 $T_h = 25 \text{ }^\circ\text{C}$   
 $Z_L = 6,25 \text{ } \Omega$  in series with  $10,4 \text{ nH}$  (in parallel with  $-267 \text{ pF}$ )

The graphs hold for one transistor of a push-pull amplifier with cross neutralization; collector (Tr1) - base (Tr2), neutralizing capacitor:  $82 \text{ pF}$ .





S.S.B. class AB operation

$P_L = 150 \text{ W (PEP)}$

$V_{CC} = 50 \text{ V}$

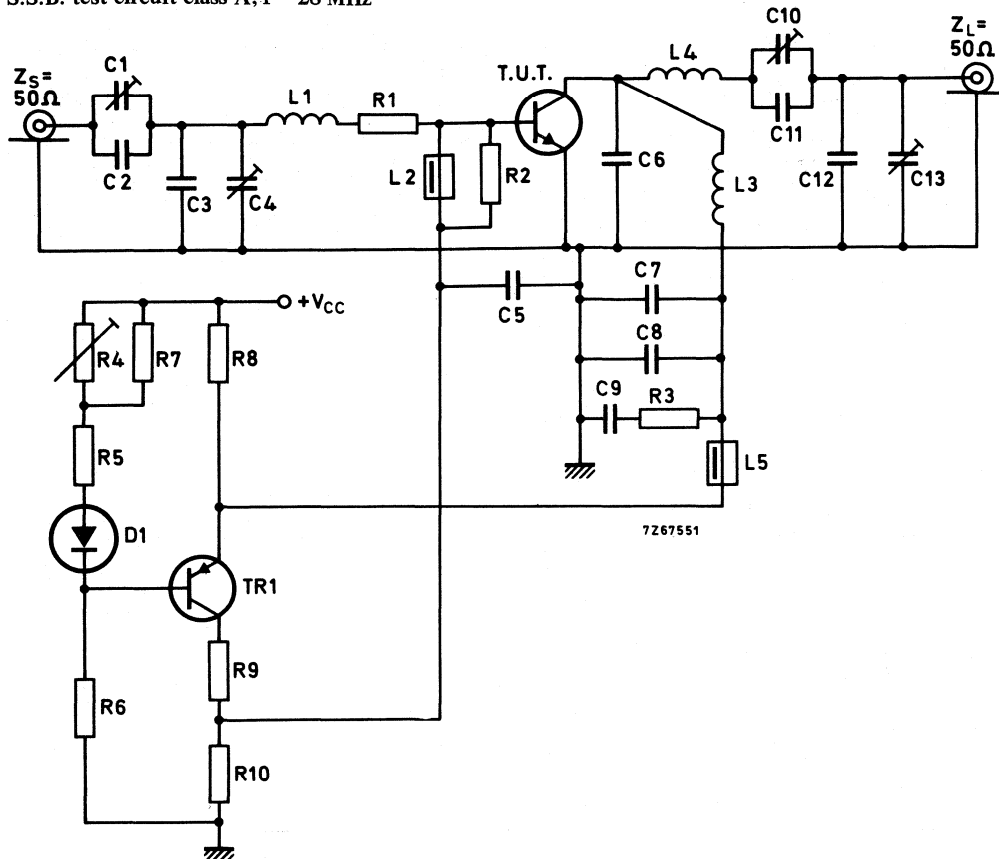
$I_{CZS} = 100 \text{ mA}$

$T_h = 25 \text{ }^\circ\text{C}$

$Z_L = 6,25 \text{ } \Omega$  in series with  $7,3 \text{ nH}$  (in parallel with  $-188 \text{ pF}$ )

The graphs hold for an unneutralized amplifier.

## APPLICATION INFORMATION (continued)

S.S.B. test circuit class-A;  $f = 28 \text{ MHz}$ 

List of components: (see also page 11)

D1 = BY206

TR1 = BD204

C1 = C10 = 100 pF air dielectric capacitor (single insulated rotor type)

C2 = C6 = 27 pF ceramic capacitor

C3 = 180 pF ceramic capacitor

C4 = C13 = 100 pF air dielectric capacitor (single non-insulated rotor)

C5 = C7 = 3,9 nF polyester capacitor ( $\pm 10\%$ )C8 = 100 nF polyester capacitor ( $\pm 10\%$ )C9 = 2,2  $\mu\text{F}$  moulded metallized polyester capacitor

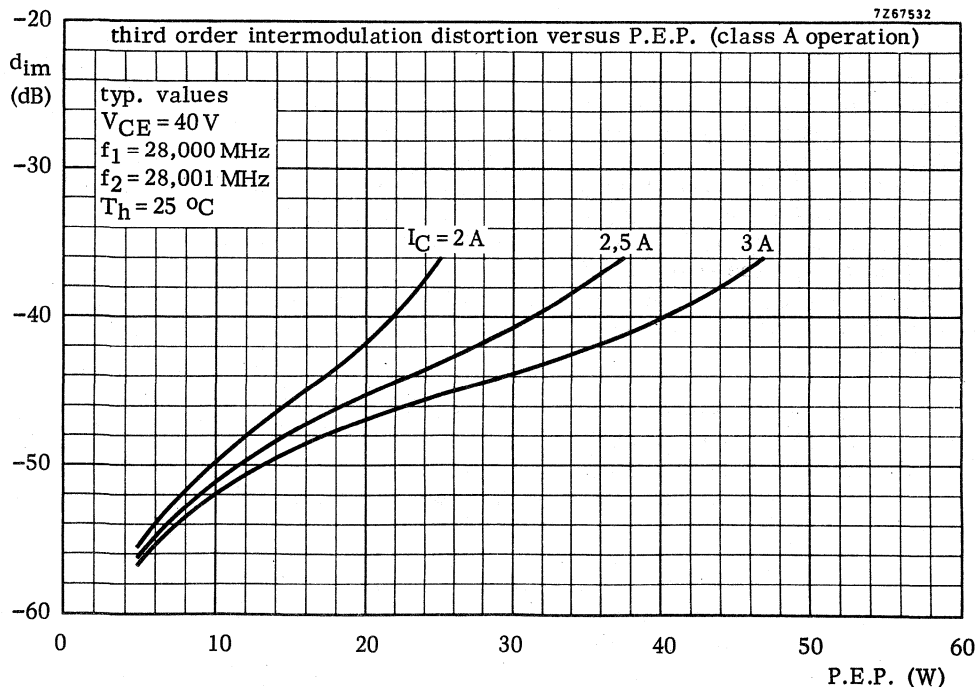
C11 = 68 pF ceramic capacitor

C12 = 220 pF ceramic capacitor

## APPLICATION INFORMATION (continued)

List of components: (continued)

- L1 = 88 nH; 3 turns Cu wire (1,0 mm); internal diameter 9 mm; coil length 6,1 mm; leads 2 x 5 mm
- L2 = L5 = ferroxcube bead, grade 3B (code number 4312 020 36440)
- L3 = 180 nH; 4 turns enamelled Cu wire (1,5 mm); internal diameter 12 mm; coil length 9,9 mm; leads 2 x 10 mm
- L4 = 350 nH; 7 turns enamelled Cu wire (1,5 mm); internal diameter 12 mm; coil length 19,1 mm; leads 2 x 10 mm
- R1 = 0,66  $\Omega$  parallel connection of 5 x 3,3  $\Omega$  carbon resistors ( $\pm 5\%$ ; 0,5 W each)
- R2 = 27  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)
- R3 = 4,7  $\Omega$  carbon resistor ( $\pm 5\%$ ; 0,5 W)
- R4 = 50  $\Omega$  wire-wound potentiometer (1 W)
- R5 = 10  $\Omega$  carbon resistor ( $\pm 5\%$ ; 1 W)
- R6 = 560  $\Omega$  enamelled wire-wound resistor (5,5 W)
- R7 = 270  $\Omega$  carbon resistor ( $\pm 5\%$ ; 1 W)
- R8 = 0,6  $\Omega$  parallel connection of 3 x 1,8  $\Omega$  wire-wound resistors (8 W each)
- R9 = 90  $\Omega$  parallel connection of 3 x 270  $\Omega$  enamelled wire-wound resistor (5,5 W each)
- R10 = 12  $\Omega$  carbon resistor ( $\pm 5\%$ ; 1 W)



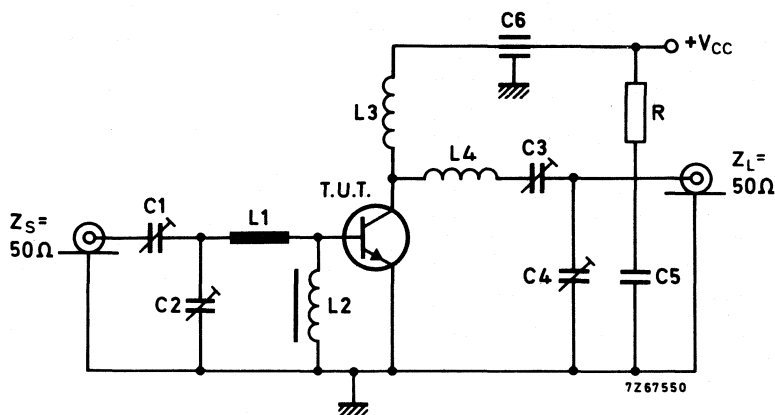
## APPLICATION INFORMATION (continued)

R.F. performance in c.w. operation (class-B circuit)

 $V_{CE} = 50 \text{ V}$ ;  $T_h$  up to  $25 \text{ }^\circ\text{C}$ 

f (MHz)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)
70	< 15	150	< 4,6	> 10	> 65
108	typ. 27	150	typ. 4,0	typ. 7,4	typ. 75

Test circuit: 70 MHz; c.w. class-B.



## List of components:

L1 = 60 mm straight enamelled Cu wire (1,6 mm); 9 mm above chassis

L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 18 turns enamelled Cu wire (1,6 mm); internal diameter 10 mm; pitch 2 mm; leads 55 mm totally

L4 = 3 turns enamelled Cu wire (1,6 mm); internal diameter 10 mm; pitch 2,5 mm; leads 50 mm totally

C1 = 4 to 29 pF concentric air trimmer in parallel with 10 pF ceramic capacitor

C2 = 4 to 104 pF film dielectric trimmer in parallel with 56 pF ceramic capacitor

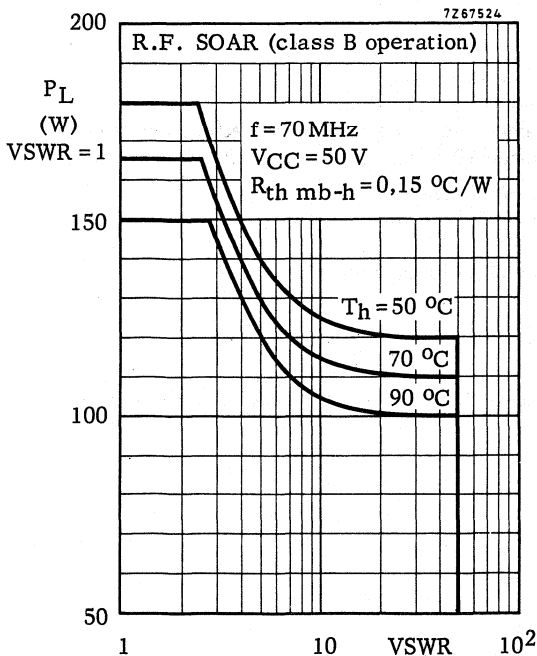
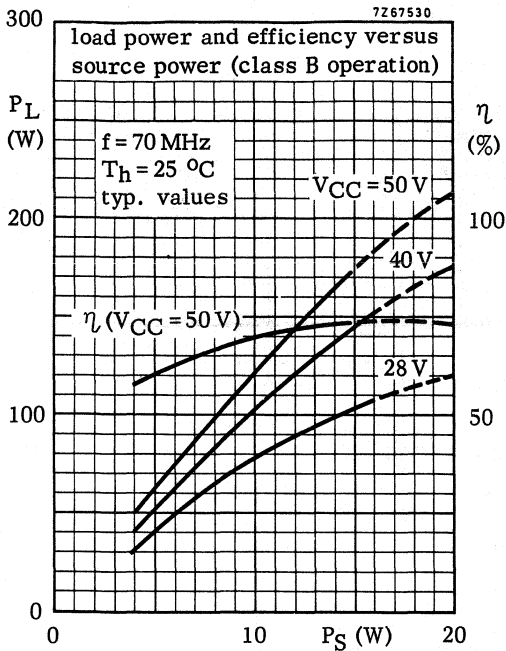
C3 = 4 to 104 pF film dielectric trimmer

C4 = 4 to 104 pF film dielectric trimmer in parallel with 47 pF ceramic capacitor

C5 = 100 nF polyester capacitor ( $\pm 10\%$ )

C6 = 1 nF ceramic feed-through capacitor

R =  $10 \Omega$  carbon resistor (0,5 W)At  $P_L = 150 \text{ W}$  and  $V_{CE} = 50 \text{ V}$ , the output power at heatsink temperatures between  $25 \text{ }^\circ\text{C}$  and  $75 \text{ }^\circ\text{C}$  relative to that at  $25 \text{ }^\circ\text{C}$  is diminished by  $100 \text{ mW/K}$ .



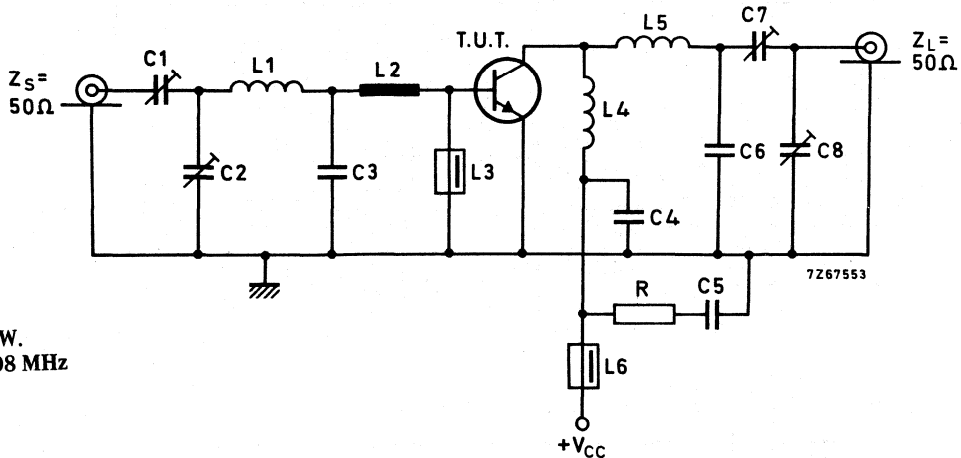
Indicated load power as a function of overload.

The graph has been derived from an evaluation of the performance of transistors matched up to 180W load power in the test amplifier and subsequently subjected to various mismatch conditions at 50V with VSWR up to 50 and elevated heatsink temperatures.

This indicates a restriction to the load power matched under nominal conditions in the recommended test configuration.

## APPLICATION INFORMATION (continued)

Test circuit:



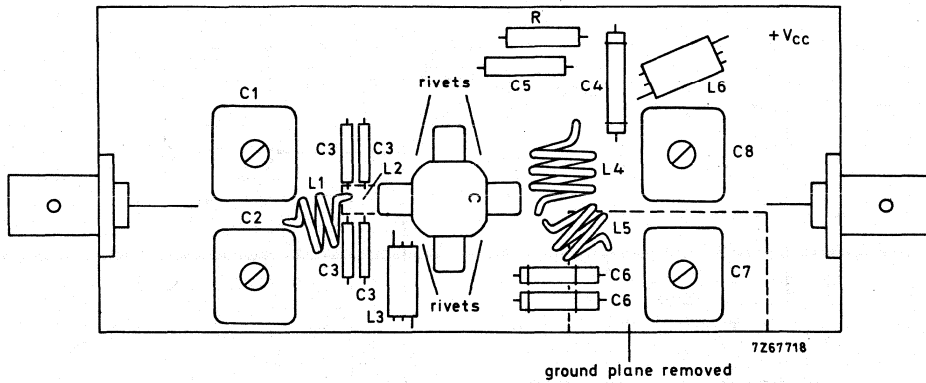
C.W.  
108 MHz

List of components:

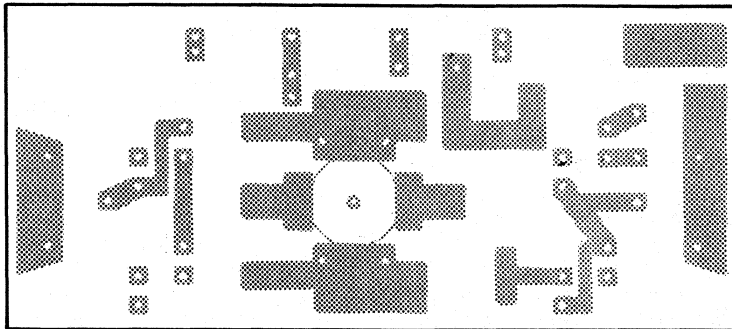
- C1 = C2 = 40 pF film dielectric trimmer  
 C3 = 400 pF parallel connection of 4 x 100 pF ceramic capacitors  
 C4 = 270 pF ceramic capacitor  
 C5 = 100 nF polyester capacitor ( $\pm 10\%$ )  
 C6 = 20 pF parallel connection of 2 x 10 pF ceramic capacitors  
 C7 = C8 = 60 pF film dielectric trimmer  
 L1 = 49 nH; 2 turns enamelled Cu wire (1,5 mm); internal diameter 9 mm;  
 coil length 4,8 mm; leads 2 x 5 mm  
 L2 = strip-line (7,7 mm x 6 mm); tap for C3 is 7,5 mm from transistor edge  
 L3 = L6 = ferroxcube bead, grade 3B (code number 4312 020 36640)  
 L4 = 67 nH; 3 turns enamelled Cu wire (1,5 mm); internal diameter 8 mm;  
 coil length 8,3 mm; leads 2 x 5 mm  
 L5 = 57 nH; 2 turns enamelled Cu wire (1,5 mm); internal diameter 10 mm;  
 coil length 4,5 mm; leads 2 x 5 mm  
 R = 10  $\Omega$  carbon resistor (0,5 W)

## APPLICATION INFORMATION (continued)

Component lay-out and printed circuit board for 108 MHz test circuit.

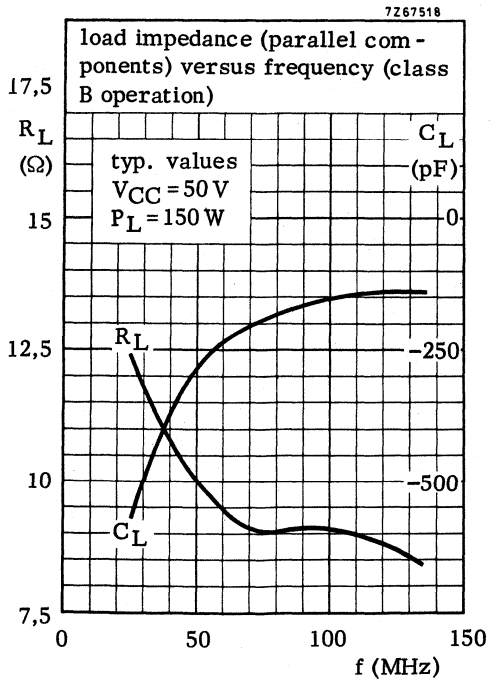
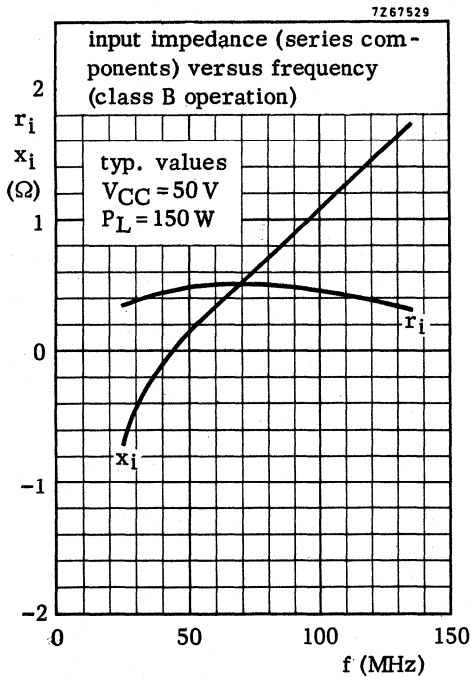
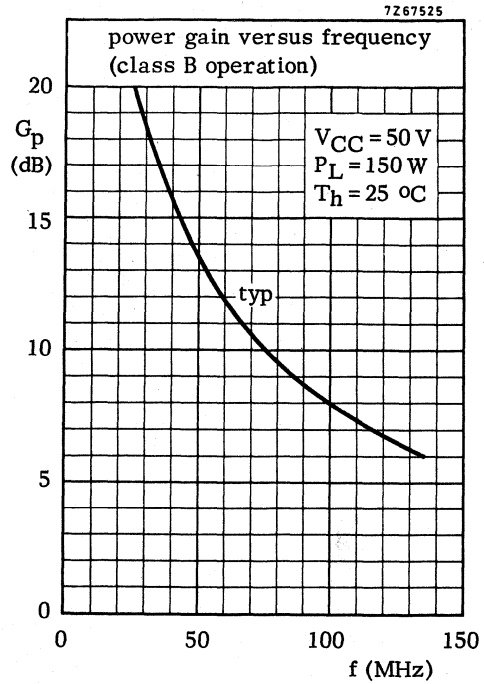
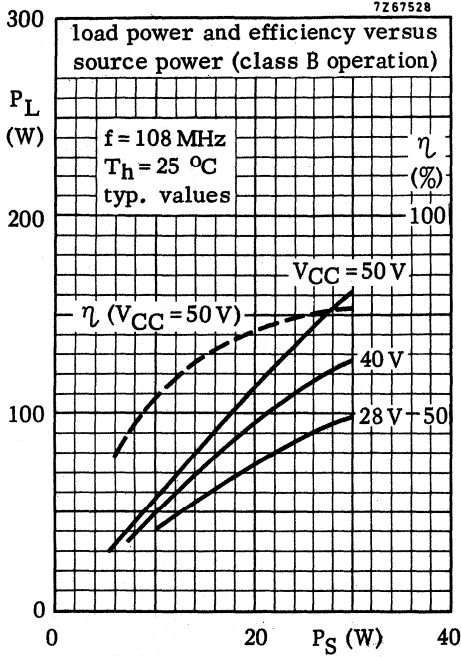


Dimensions of printed circuit board 123 mm x 55 mm.



7Z67664

The circuit has been built on epoxy fibre-glass double copper clad printed circuit board (thickness 1/16"). To minimize the dielectric losses, the ground plane under the interconnection of L5, C6 and C7 has been removed.





## H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated h.f. and v.h.f. transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Matched  $h_{FE}$  groups are available on request.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

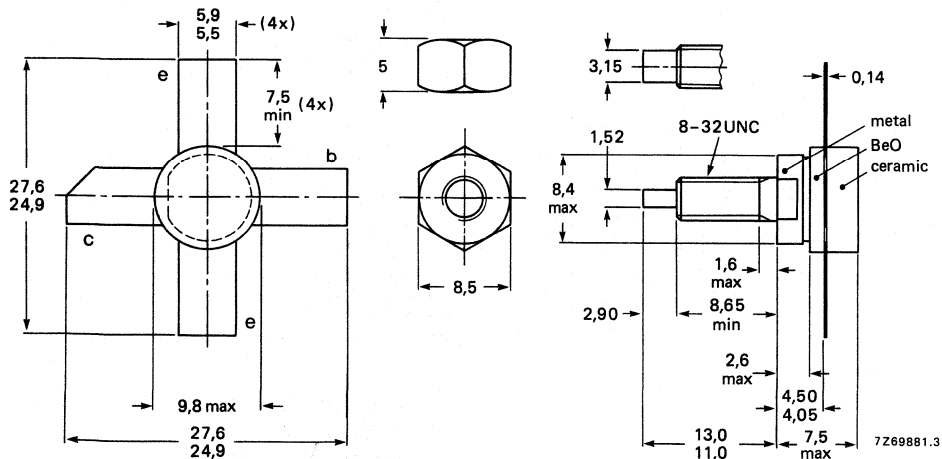
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS	$d_3$ dB
c.w. (class-B)	28	175	45	> 7,5	> 70	$0,7 + j1,3$	$110 - j62$	—
s.s.b. (class-AB)	28	1,6–28	5–42,5 (P.E.P)	typ. 19	typ. 50	—	—	typ. -30
s.s.b. (class-A)	26	1,6–28	15 (P.E.P)	typ. 20	—	—	—	typ. -42

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open-collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	4 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	12 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	100 W
Storage temperature	$T_{stg}$		- 65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

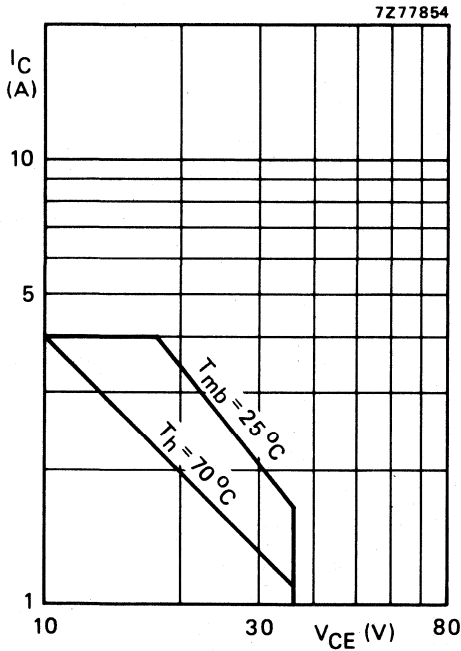


Fig. 2 D.C. SOAR.

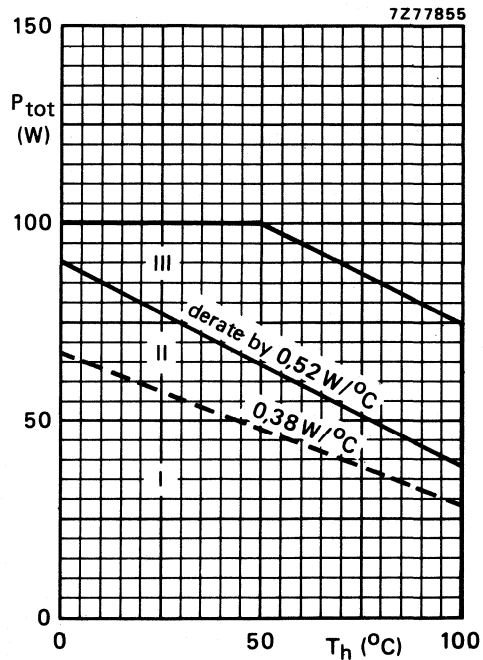


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 40 W;  $T_{mb} = 88$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	2,8 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	2,05 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,45 K/W

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$$V_{BE} = 0; I_C = 25\text{ mA}$$

$$V_{(BR)CES} > 65\text{ V}$$

Collector-emitter breakdown voltage

$$\text{open base; } I_C = 100\text{ mA}$$

$$V_{(BR)CEO} > 36\text{ V}$$

Emitter-base breakdown voltage

$$\text{open collector; } I_E = 10\text{ mA}$$

$$V_{(BR)EBO} > 4\text{ V}$$

Collector cut-off current

$$V_{BE} = 0; V_{CE} = 36\text{ V}$$

$$I_{CES} < 10\text{ mA}$$

Second breakdown energy;  $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$

open base

$$R_{BE} = 10\ \Omega$$

$$E_{SBO} > 8\text{ mJ}$$

$$E_{SBR} > 8\text{ mJ}$$

D.C. current gain \*

$$I_C = 2,5\text{ A; } V_{CE} = 5\text{ V}$$

$$h_{FE} \text{ typ. } 45$$

$$10 \text{ to } 80$$

D.C. current gain ratio of matched devices \*

$$I_C = 2,5\text{ A; } V_{CE} = 5\text{ V}$$

$$h_{FE1}/h_{FE2} < 1,2$$

Collector-emitter saturation voltage \*

$$I_C = 7,5\text{ A; } I_B = 1,5\text{ A}$$

$$V_{CEsat} \text{ typ. } 1,5\text{ V}$$

Transition frequency at  $f = 100\text{ MHz}$  \*

$$-I_E = 2,5\text{ A; } V_{CB} = 28\text{ V}$$

$$-I_E = 7,5\text{ A; } V_{CB} = 28\text{ V}$$

$$f_T \text{ typ. } 570\text{ MHz}$$

$$f_T \text{ typ. } 570\text{ MHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 28\text{ V}$$

$$C_c \text{ typ. } 82\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 100\text{ mA; } V_{CE} = 28\text{ V}$$

$$C_{re} \text{ typ. } 54\text{ pF}$$

Collector-stud capacitance

$$C_{cs} \text{ typ. } 2\text{ pF}$$

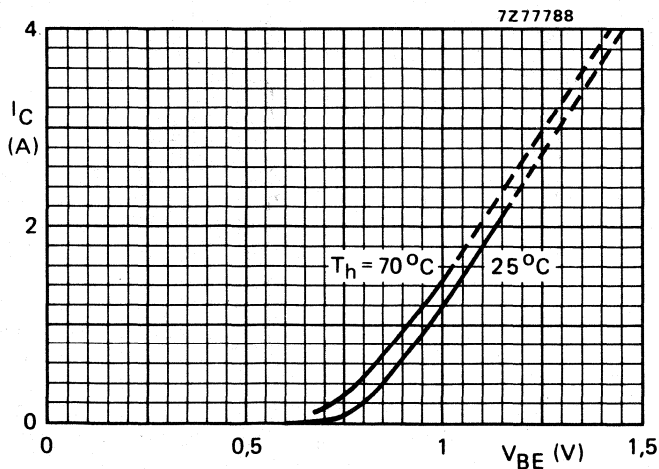


Fig. 4 Typical values;  $V_{CE} = 28\text{ V}$ .

\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}$ ;  $\delta \leq 0,02$ .

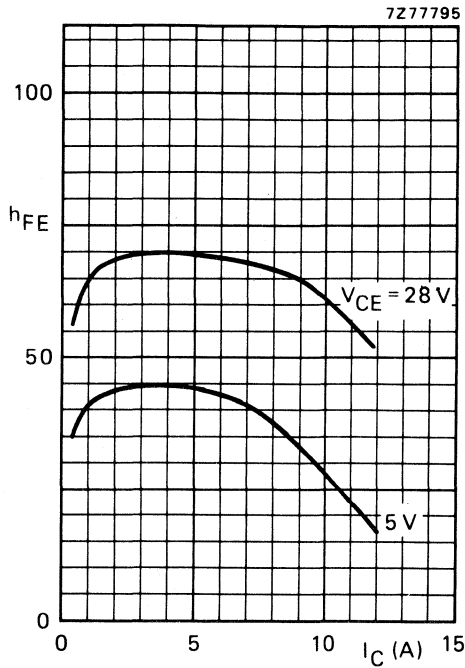


Fig. 5 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

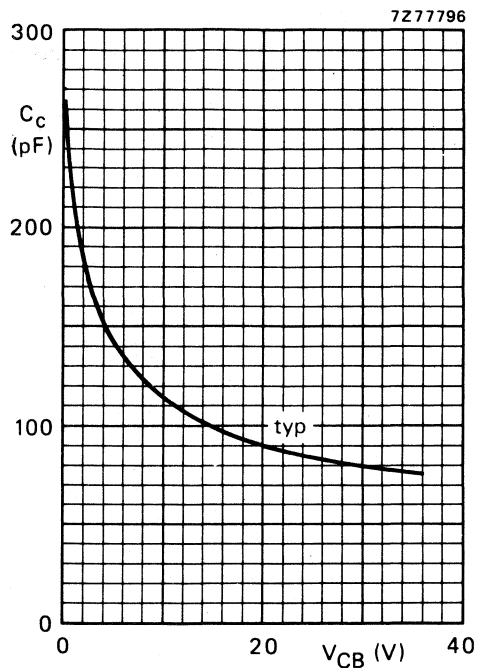


Fig. 6  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

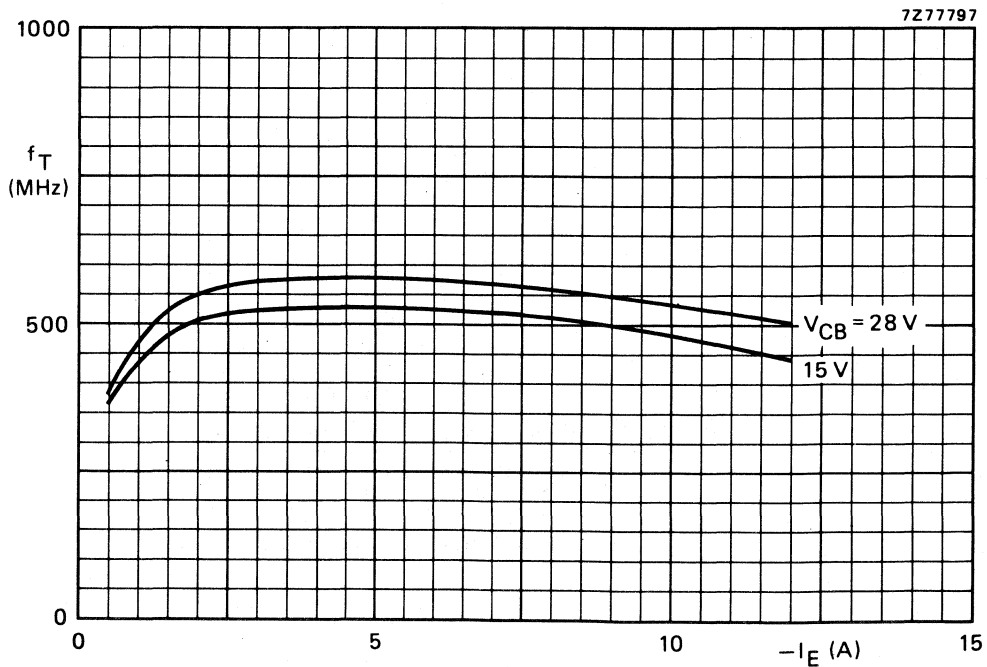


Fig. 7 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	28	45	< 8	> 7,5	< 2,47	> 70	$0,7 + j1,3$	$110 - j62$

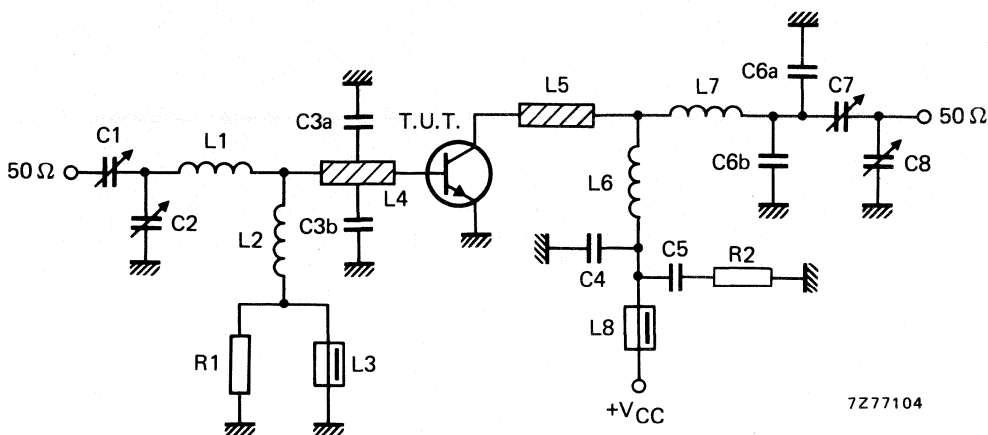


Fig. 8 Test circuit; c.w. class-B.

List of components:

C1 = C7 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C6a = 2,2 pF ceramic capacitor (500 V)

C6b = 1,8 pF ceramic capacitor (500 V)

C8 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

L1 = 14 nH; 1 turn Cu wire (1,6 mm); int. dia. 7,7 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L6 = 80 nH; 3 turns Cu wire (1,6 mm); int. dia. 9,0 mm; length 8,0 mm; leads 2 x 5 mm

L7 = 62 nH; 3 turns Cu wire (1,6 mm); int. dia. 7,5 mm; length 8,1 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor.

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 9.

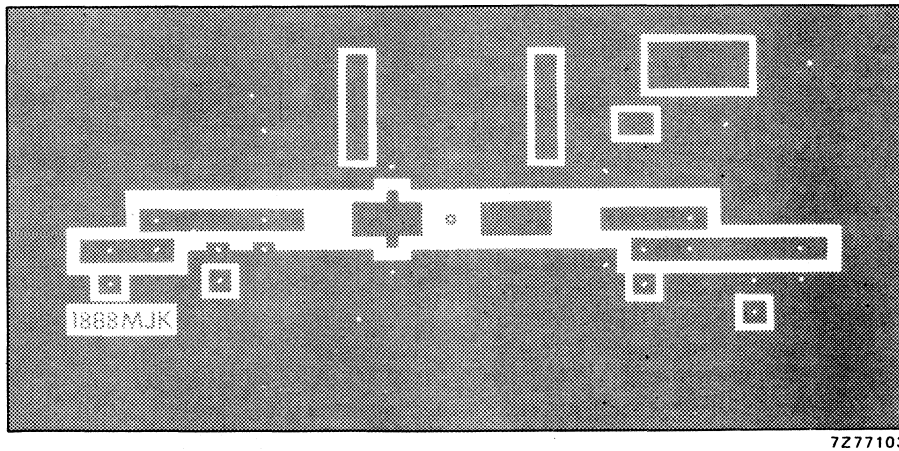
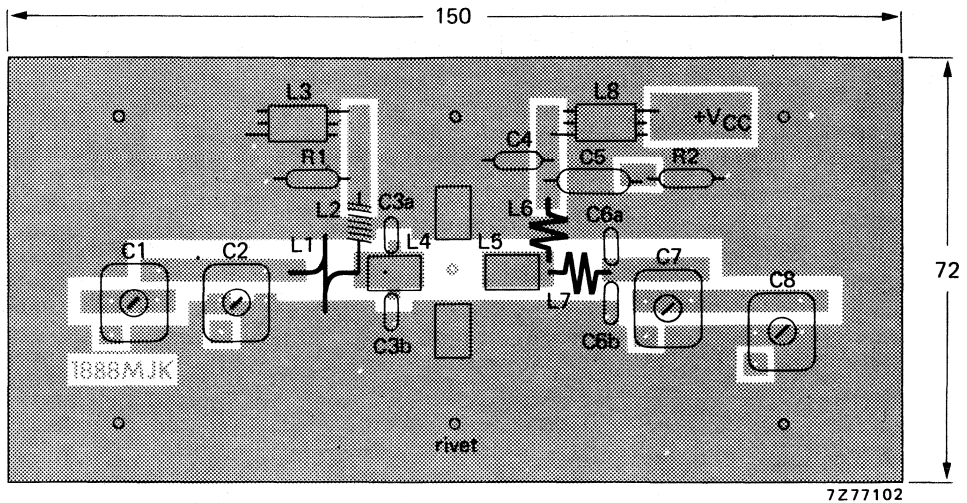


Fig. 9 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

To minimize the dielectric losses, the ground plane under the interconnection of L7 and C7 has been removed.

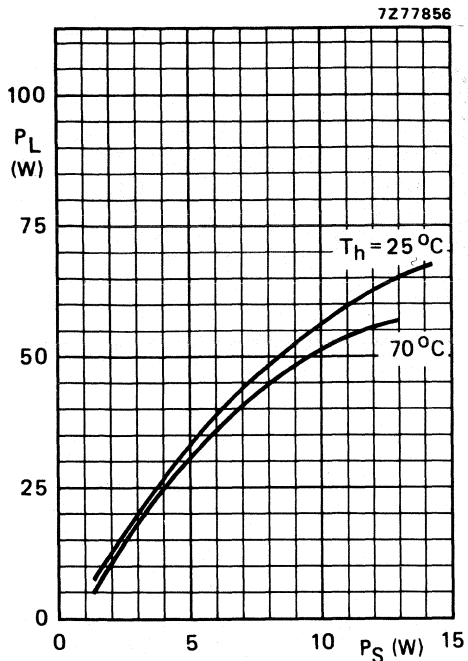


Fig. 10 Typical values;  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ .

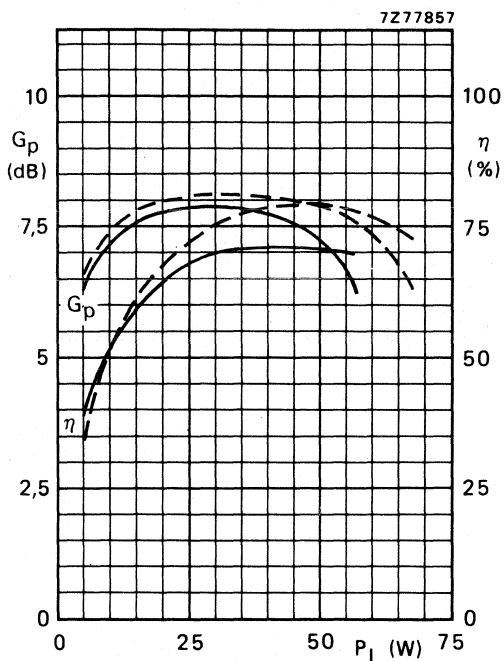


Fig. 11 Typical values;  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ ; ---  $T_h = 25^\circ\text{C}$ ; —  $T_h = 70^\circ\text{C}$ .

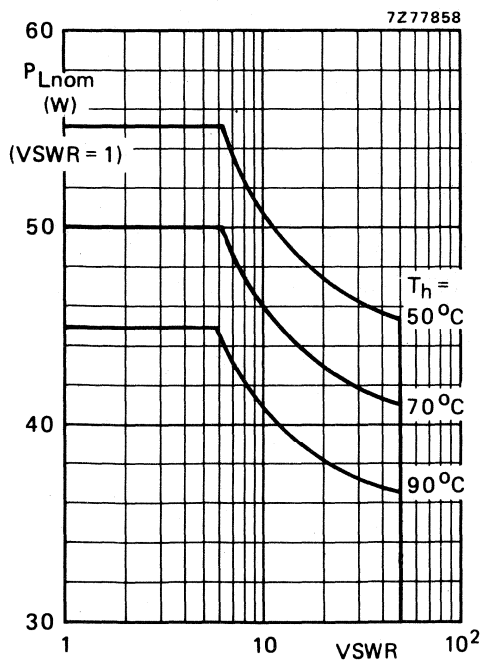


Fig. 12 R.F. SOAR; c.w. class-B operation;  $f = 175\text{ MHz}$ ;  $V_{CE} = 28\text{ V}$ ;  $R_{th\text{ mb-h}} = 0,45\text{ K/W}$   
The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

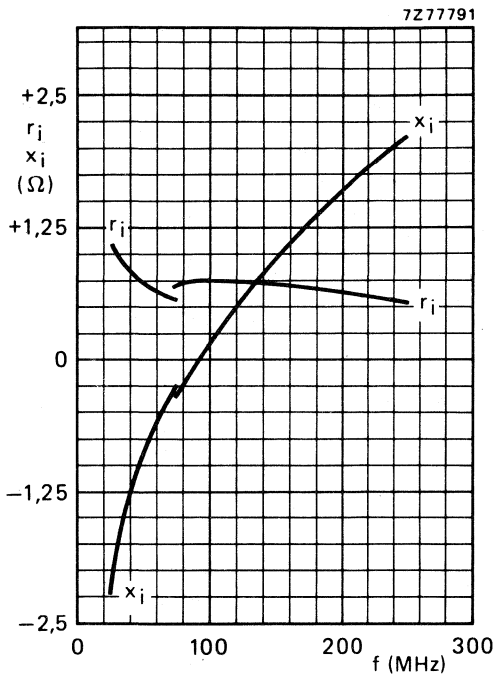


Fig. 13 Input impedance (series components).

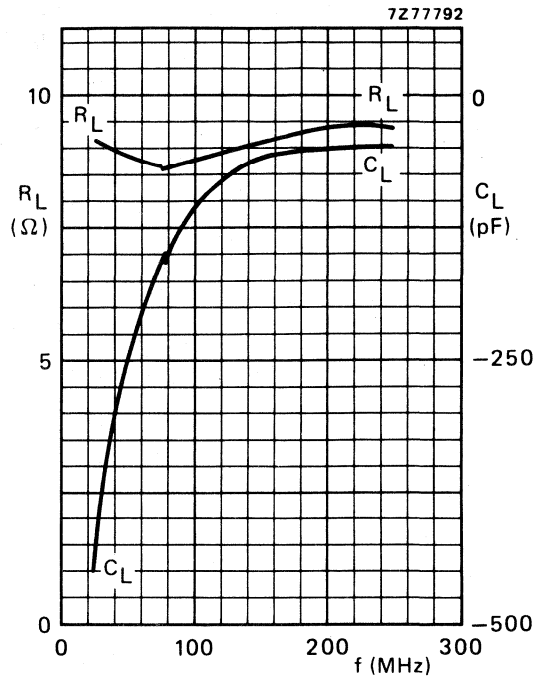


Fig. 14 Load impedance (parallel components).

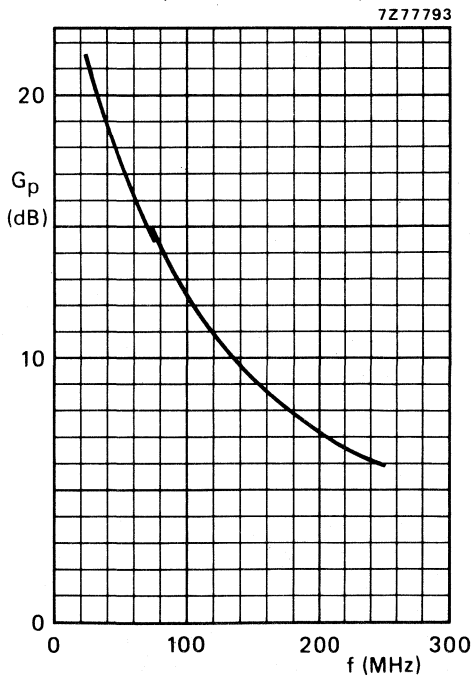


Fig. 15 Power gain versus frequency.

**OPERATING NOTE**

Below 75 MHz a base-emitter resistor of  $10 \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

Conditions for Figs 13; 14 and 15.

Typical values;  $V_{CE} = 28 \text{ V}$ ;  $P_L = 45 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ .



R.F. performance in s.s.b. class-AB operation (linear power amplifier)

 $V_{CE} = 28 \text{ V}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ 

output power W	$G_p$ dB	$\eta_{dt}(\%)$ at 42,5 W (P.E.P)	$I_C$ (A) at 42,5 W (P.E.P)	$d_3$ dB*	$d_5$ dB*	$I_{C(ZS)}$ mA	$T_h$ $^{\circ}\text{C}$
5 to 42,5(P.E.P)	typ. 19	typ. 50	typ. 1,52	typ. -30	< -30	50	25
5 to 37,5(P.E.P)	typ. 19	—	—	typ. -30	< -30	50	70

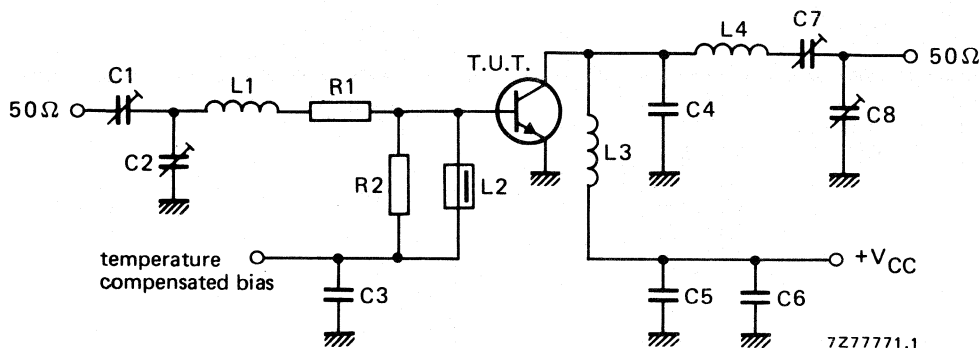


Fig. 16 Test circuit; s.s.b. class-AB.

List of components:

C1 = C2 = 10 to 780 pF film dielectric trimmer

C3 = C5 = C6 = 220 nF polyester capacitor

C4 = 56 pF ceramic capacitor (500 V)

C7 = C8 = 15 to 575 pF film dielectric capacitor

L1 = 4 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 7,0 mm; leads 2 x 5 mm

L2 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = 4 turns enamelled Cu wire (1,6 mm); int. dia. 10 mm; length 9,4 mm; leads 2 x 5 mm

L4 = 7 turns enamelled Cu wire (1,6 mm); int. dia. 12 mm; length 17,2 mm; leads 2 x 5 mm

R1 = 1,2 Ω; parallel connection of 4 x 4,7 Ω carbon resistors

R2 = 39 Ω carbon resistor

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

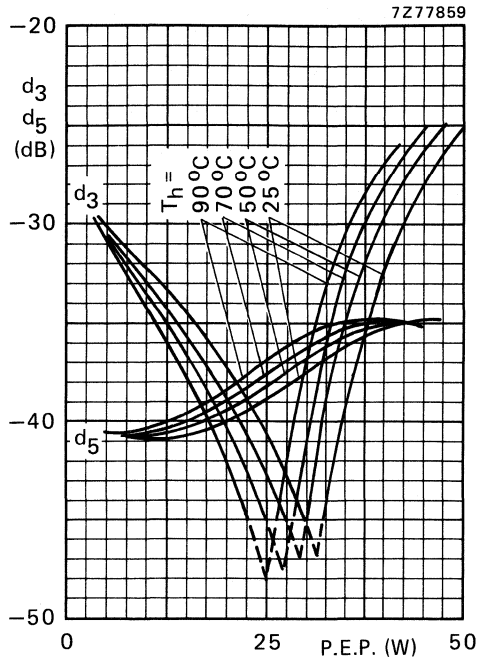


Fig. 17 Intermodulation distortion as a function of output power.\*

Conditions for Fig. 17:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ; typical values.

Conditions for Fig. 18:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $T_H = 70 \text{ }^\circ\text{C}$ ; typical values.

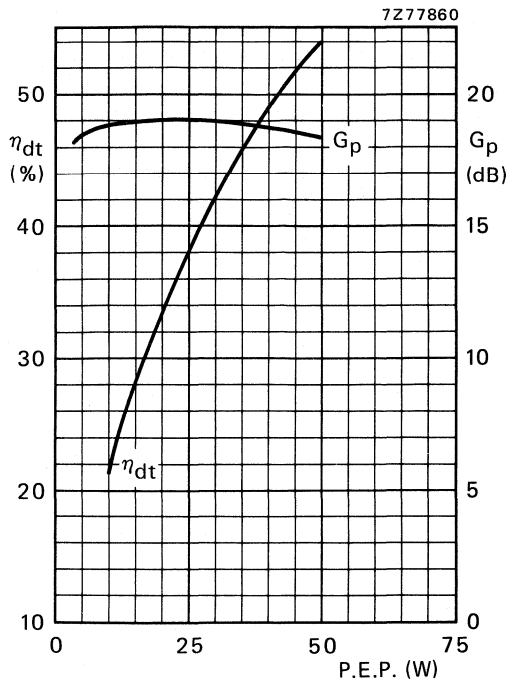


Fig. 18 Double-tone efficiency and power gain as a function of output power.

\* See note on previous page.

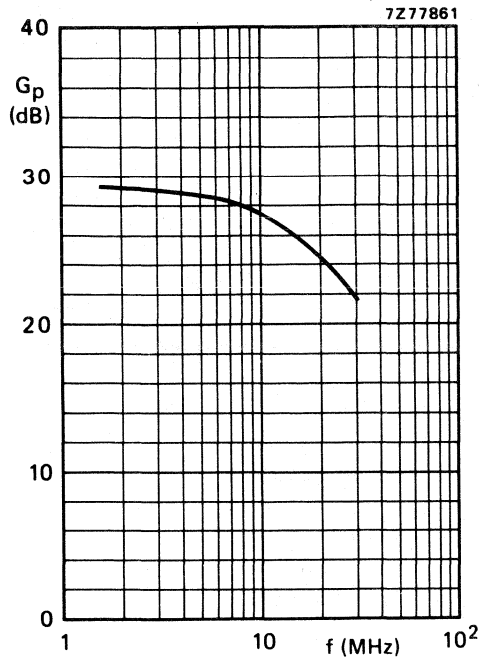


Fig. 19 Power gain as a function of frequency.

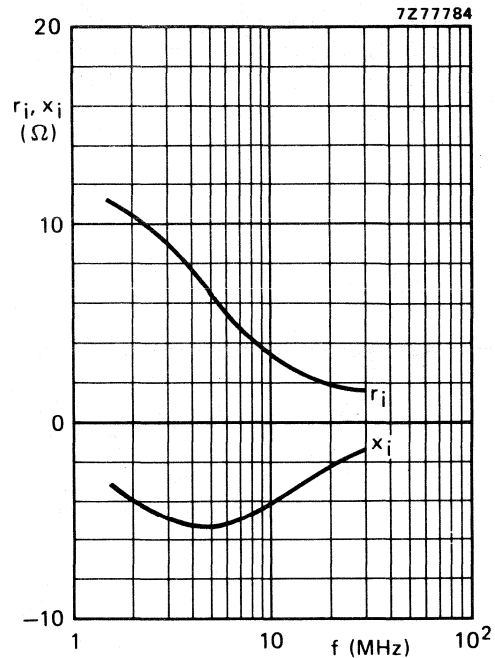


Fig. 20 Input impedance (series components) as a function of frequency.

Figs 19 and 20 are typical curves and hold for an unneutralized amplifier in s.s.b. class-AB operation.

Conditions:

$V_{CE} = 28 \text{ V}$ ;  $I_{C(ZS)} = 50 \text{ mA}$ ;  $P_L = 42,5 \text{ W}$ ;  $T_h = 25 \text{ }^\circ\text{C}$ ;  $Z_L = 7,4 \text{ } \Omega$ .

#### Ruggedness in s.s.b. operation

The BLX39 is capable of withstanding a load mismatch (VSWR = 50) under the following conditions:

Class-AB operation;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$ ;  $V_{CE} = 28 \text{ V}$ ;  $T_h = 70 \text{ }^\circ\text{C}$  and  $P_{Lnom} = 45 \text{ W P.E.P.}$

R.F. performance in s.s.b. class-A operation (linear power amplifier)

$V_{CE} = 26 \text{ V}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  $f_1 = 28,000 \text{ MHz}$ ;  $f_2 = 28,001 \text{ MHz}$

output power W	$G_p$ dB	$I_C$ A	$d_3$ dB *	$d_5$ dB *
15 (P.E.P)	typ. 20	1,55	typ. -42	< -40

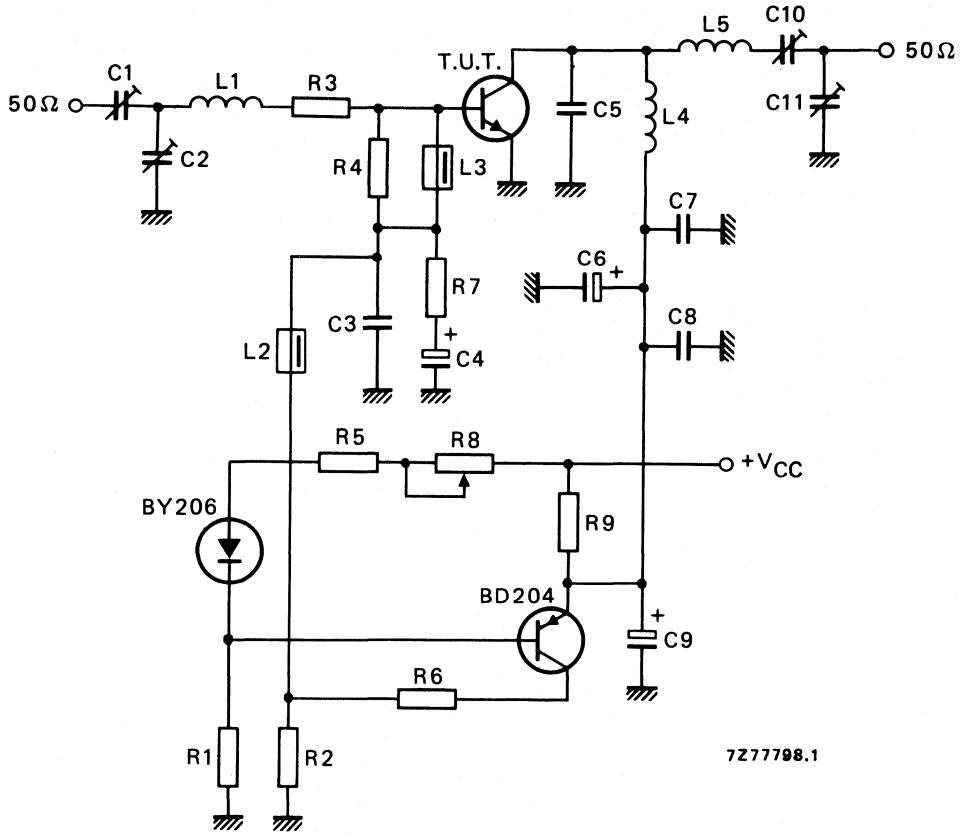


Fig. 21 Test circuit; s.s.b. class-A.

\* Stated intermodulation distortion figures are referred to the according level of either of the equal amplified tones. Relative to the according peak envelope powers these figures should be increased by 6 dB.

List of components in Fig. 21:

C1 = C2 = 10 to 780 pF film dielectric trimmer

C3 = 22 nF ceramic capacitor (63 V)

C4 = 47  $\mu$ F/10 V electrolytic capacitor

C5 = 56 pF ceramic capacitor (500 V)

C6 = 47  $\mu$ F/35 V electrolytic capacitor

C7 = C8 = 220 nF polyester capacitor

C9 = 10  $\mu$ F/35 V electrolytic capacitor

C10 = 10 to 210 pF film dielectric trimmer

C11 = 15 to 575 pF film dielectric trimmer

L1 = 3 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L2 = L3 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = 11 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 11,0 mm

L5 = 14 turns closely wound enamelled Cu wire (1,6 mm); int. dia. 11,0 mm

R1 = 600  $\Omega$ ; parallel connection of 2 x 1,2 k $\Omega$  carbon resistors ( $\pm$  5%; 0,5 W each)

R2 = 15  $\Omega$  carbon resistor ( $\pm$  5%; 0,25 W)

R3 = 1,2  $\Omega$ ; parallel connection of 4 x 4,7  $\Omega$  carbon resistors ( $\pm$  5%; 0,125 W each)

R4 = 33  $\Omega$  carbon resistor ( $\pm$  5%; 0,25 W)

R5 = 18  $\Omega$  carbon resistor ( $\pm$  5%; 0,25 W)

R6 = 120  $\Omega$  wirewound resistor ( $\pm$  5%; 5,5 W)

R7 = 1  $\Omega$  carbon resistor ( $\pm$  5%; 0,125 W)

R8 = 47  $\Omega$  wirewound potentiometer (3 W)

R9 = 1,57  $\Omega$ ; parallel connection of 3 x 4,7  $\Omega$  wirewound resistors ( $\pm$  5%; 5,5 W each)

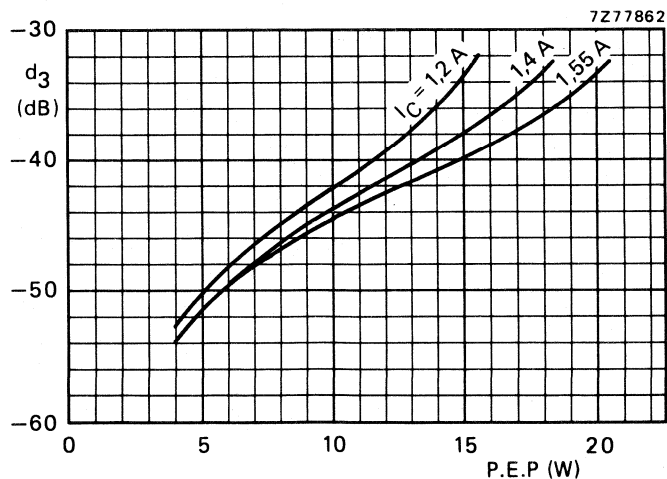


Fig. 22 Intermodulation distortion as a function of output power. Typical values;  $V_{CE} = 26$  V;  $T_h = 70$  °C;  $f_1 = 28,000$  MHz;  $f_2 = 28,001$  MHz.



## U.H.F./V.H.F. TRANSMITTING TRANSISTOR

N-P-N transistor intended for use in class-B and C operated mobile, industrial and military transmitters with a supply voltage of 13,8 V. It has a TO-39 metal envelope with the collector connected to the case.

### QUICK REFERENCE DATA

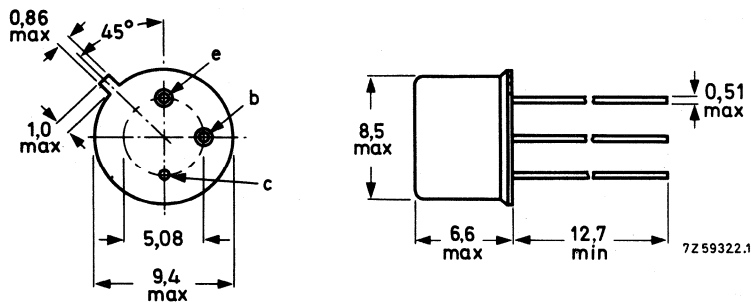
R.F. performance up to  $T_{\text{case}} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{\text{CE}}$ V	f MHz	$P_{\text{S}}$ W	$P_{\text{L}}$ W	$I_{\text{C}}$ A	$G_{\text{p}}$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_{\text{L}}$ mS
c.w.	13,8	470	typ. 0,4	2,0	typ. 0,22	typ. 7	typ. 66	$5 + j11$	$17 - j19$
c.w.	12,5	470	< 0,5	2,0	< 0,25	> 6	> 65	—	—
c.w.	12,5	175	typ. 0,12	2,0	typ. 0,21	typ. 12	typ. 75	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-39; collector connected to case.



Maximum lead diameter is guaranteed only for 12,7 mm.

Accessories: 56245 (distance disc).

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36	V
Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	36	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4	V
Collector current (average)	$I_{C(AV)}$	max.	0.7	A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	2.0	A
Total power dissipation up to $T_{case} = 90$ °C $f > 10$ MHz	$P_{tot}$	max.	3.0	W
Storage temperature	$T_{stg}$		-65 to +150	°C
Operating junction temperature	$T_j$	max	165	°C

**THERMAL RESISTANCE**

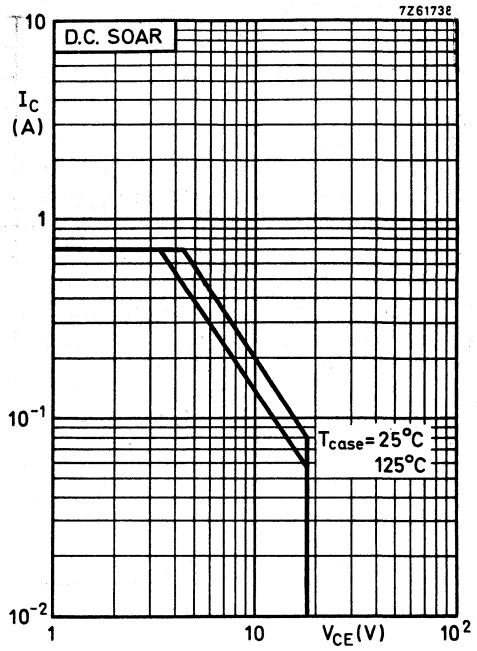
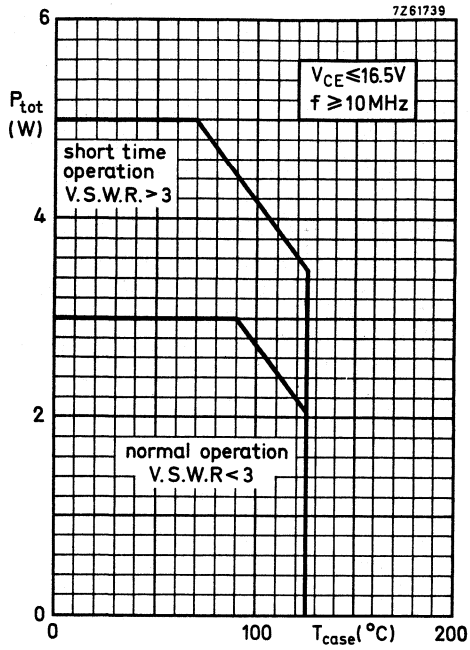
From junction to case	$R_{th\ j-c}$	=	25	K/W
From mounting base to heatsink with a boron nitride washer for electrical insulation	$R_{th\ mb-h}$	=	2.5	K/W

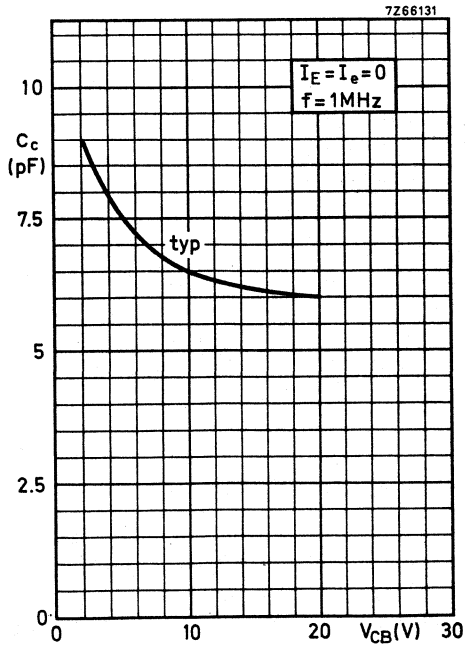
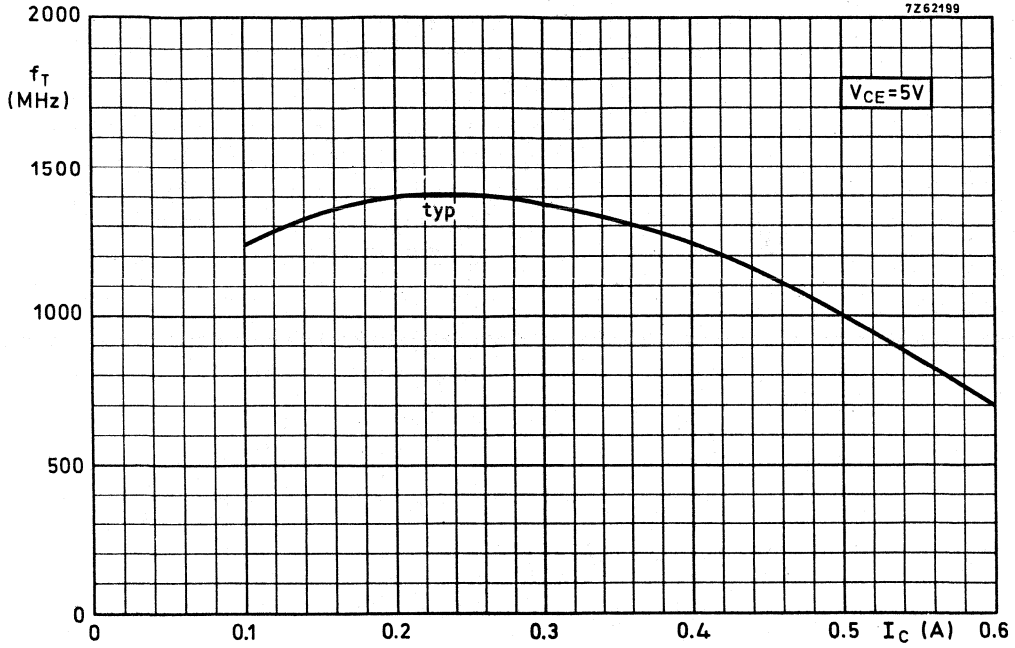


**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage open emitter, $I_C = 10\text{ mA}$	$V_{(BR)CBO}$	>	36	V
Collector-emitter voltage $V_{BE} = 0$ ; $I_C = 10\text{ mA}$	$V_{(BR)CES}$	>	36	V
Collector-emitter voltage open base, $I_C = 25\text{ mA}$	$V_{(BR)CEO}$	>	18	V
Emitter-base voltage open collector, $I_E = 1.0\text{ mA}$	$V_{(BR)EBO}$	>	4	V
Collector-emitter saturation voltage $I_C = 100\text{ mA}$ ; $I_B = 20\text{ mA}$	$V_{CEsat}$	typ.	0.1	V
D. C. current gain $I_C = 100\text{ mA}$ ; $V_{CE} = 5\text{ V}$	$h_{FE}$	> typ.	10 40	
Transition frequency $I_C = 200\text{ mA}$ ; $V_{CE} = 5\text{ V}$ ; $f = 500\text{ MHz}$	$f_T$	typ.	1400	MHz
Collector capacitance at $f = 1\text{ MHz}$ $I_E = I_e = 0$ ; $V_{CB} = 10\text{ V}$	$C_c$	typ. <	6.5 9.0	pF pF
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 20\text{ mA}$ ; $V_{CE} = 10\text{ V}$	$-C_{re}$	typ.	4.8	pF





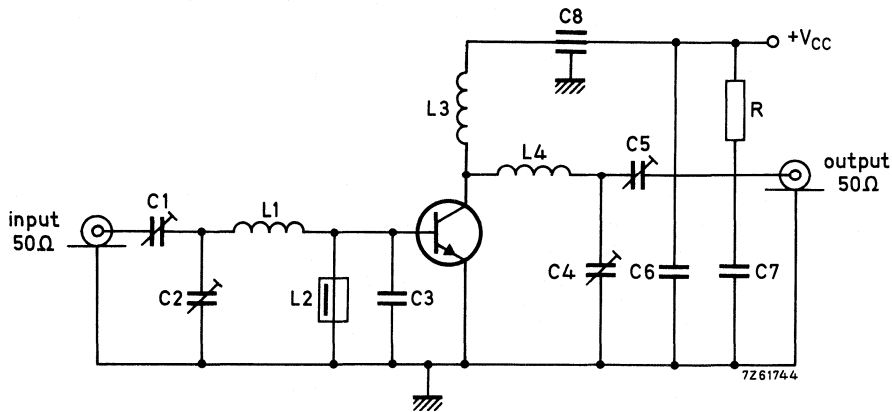
**APPLICATION INFORMATION**

R.F. performance in c.w. operation (unneutralized common-emitter class B circuit)

$T_{case}$  up to 25 °C

f (MHz)	V <sub>CC</sub> (V)	P <sub>S</sub> (W)	P <sub>L</sub> (W)	I <sub>C</sub> (A)	G <sub>p</sub> (dB)	η (%)	$\bar{z}_i$ (Ω)	$\bar{Y}_L$ mS
470	13.8	typ. 0.4	2.0	typ. 0.22	typ. 7	typ. 66	5 + j11	17 - j19
470	12.5	< 0.5	2.0	< 0.25	> 6	> 65	-	-
175	12.5	typ. 0.12	2.0	typ. 0.21	typ. 12	typ. 75	-	-

Test circuit 1 (470 Mhz)



To obtain optimum gain performance the emitter lead length should not exceed 1.6 mm

- C1 = C2 = C4 = C5 = 1.8 to 18 pF film dielectric trimmer
- C3 = 22 pF disc ceramic capacitor
- C6 = 10 nF ceramic capacitor
- C7 = 0.1 μF polyester capacitor
- C8 = 4 nF feed-through capacitor

- L1 = 1 turn Cu wire (1 mm); int. diam. 5 mm, max. lead length 1 mm
- L2 = 0.22 μH choke
- L3 = 1 turn Cu wire (1 mm); int. diam. 7 mm; lead length 2 mm
- L4 = 1 turn Cu wire (1 mm); int. diam. 5 mm; lead length 2 mm
- R = 10 Ω carbon

At  $P_L = 2.0$  W and  $V_{CC} = 12.5$  V the output power at case temperatures between 25 °C and 90 °C relative to that at 25 °C is diminished by typ. 5 mW/K

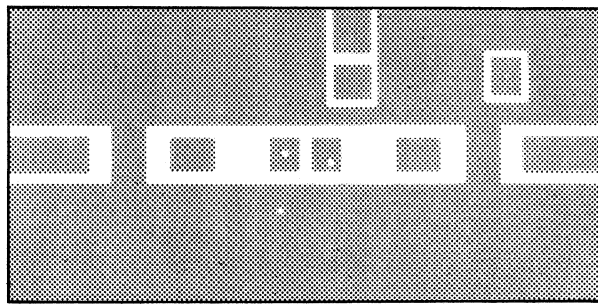
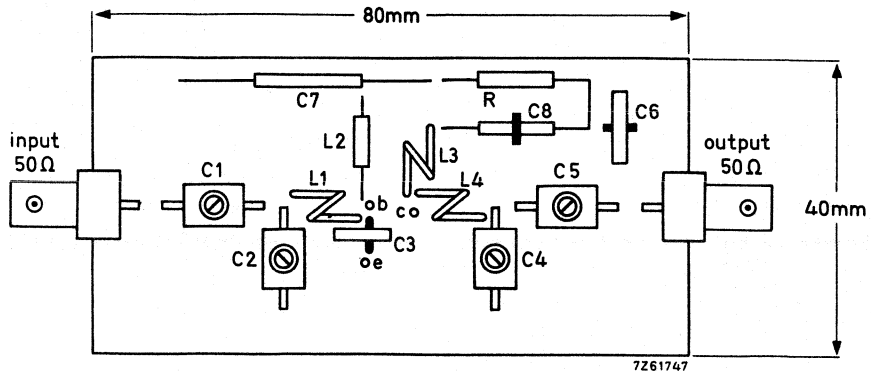
The transistor is designed to withstand full load mismatch in the test circuit under the following conditions:  $V_{CC} = 16.5$  V;  $f = 470$  MHz;  $T_{case} = 70$  °C

V.S.W.R. = 50 : 1 through all phases;  $P_S = P_{Snom} + 20\%$

where  $P_{Snom} = P_S$  for 1.4 W transistor output into 50 Ω load at  $V_{CC} = 13.8$  V.

APPLICATION INFORMATION (continued)

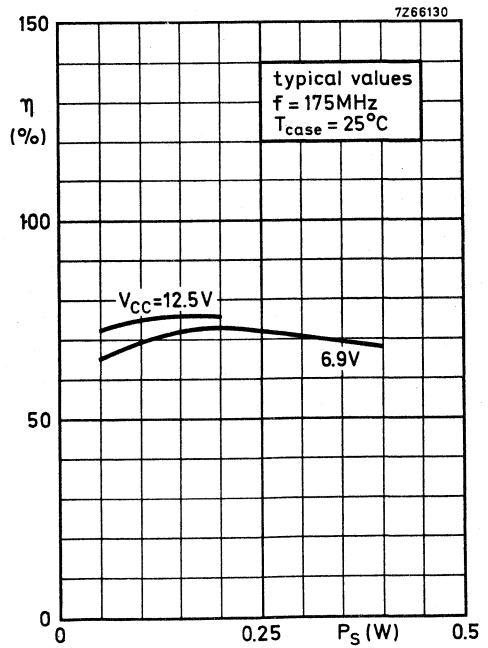
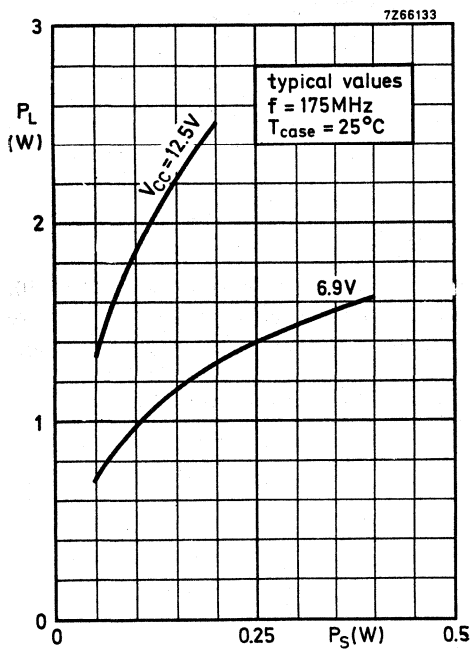
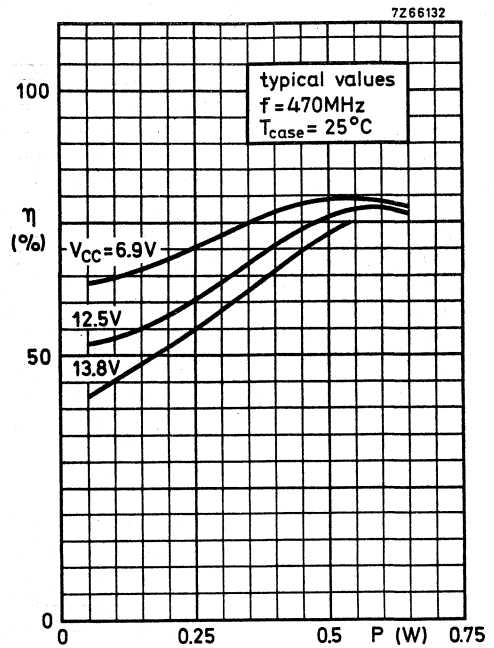
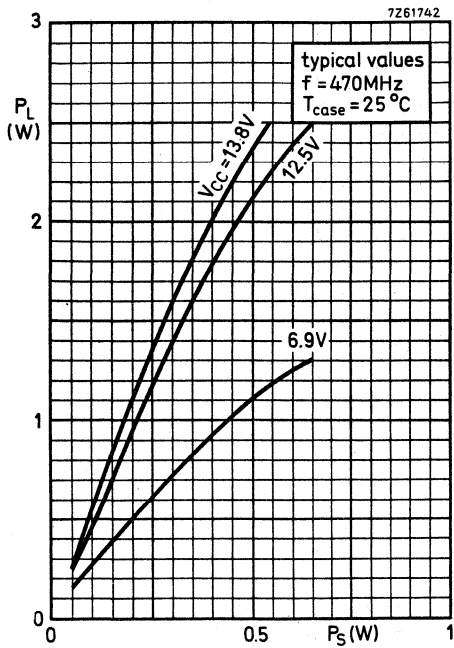
Component lay-out and printed circuit board for 470 MHz test circuit.

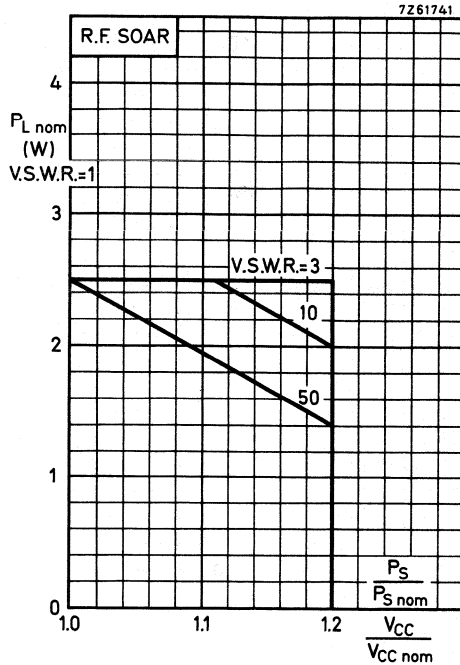


Shaded area copper

Back area not metalized

Material of printed circuit board: 1.5 mm epoxy fibre-glass





Conditions for R.F. SOAR

$f = 470 \text{ MHz}$

$P_{Snom} = P_S$  at  $V_{CC} = V_{CCnom}$  and  $V.S.W.R. = 1$

$T_{case} = 70 \text{ }^\circ\text{C}$

$V_{CCnom} = 13.8 \text{ V}$

The transistor was developed for use with unstabilized supply voltage  $V_{CC}$ .

The above graph is based on its measured performance in test circuit 1.

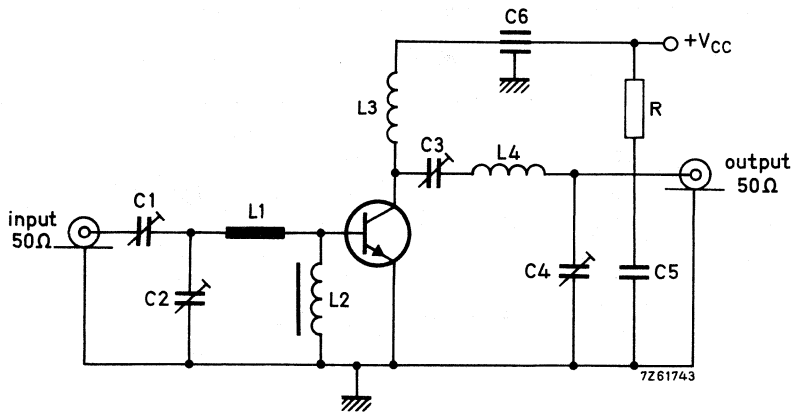
Supply voltage was varied from  $V_{CCnom}$  to  $1.2 V_{CCnom}$ , and V.S.W.R. from 1 to 50. It shows the maximum allowable output power under nominal conditions in order not to exceed the maximum allowable power dissipation under conditions of supply overvoltage ( $V_{CC} > V_{CCnom}$ ) and load mismatch ( $V.S.W.R. > 1$ ).

It is assumed that the drive power increases linearly with the supply voltage; i.e.

$P_S/P_{Snom} = V_{CC}/V_{CCnom}$ .

## APPLICATION INFORMATION (continued)

Test circuit II (175 MHz)



To obtain optimum gain performance the emitter lead length should not exceed 1.6 mm

C1 = C4 = 60 pF concentric air trimmer

C2 = C3 = 30 pF concentric air trimmer

C5 = 0.25  $\mu$ F polyester capacitor

C6 = 4 nF feed-through capacitor

L1 = 25 mm straight Cu wire (1.2 mm); height above print 3 mm

L2 = 3 turns Cu wire (0.5 mm) on ferrite FX1115,  $d = 2$  mm,  $D = 4$  mm,  $l = 5$  mm, material 3B (code number 3113 991 16740)

L3 = 5 turns closely wound Cu wire (1.2 mm); int. diam. 10 mm; lead length 5 mm

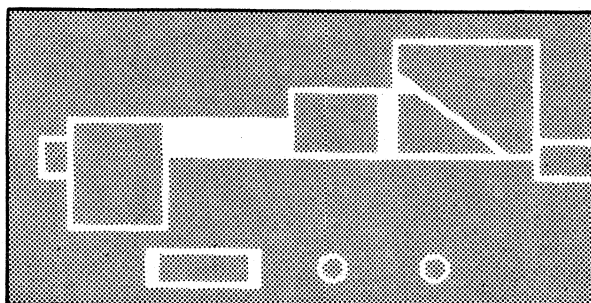
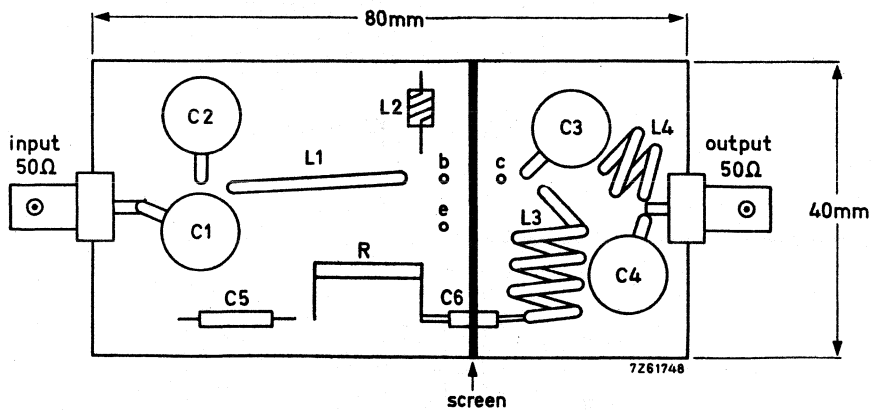
L4 = 3 turns closely wound Cu wire (1.2 mm); int. diam. 10 mm; lead length 5 mm

R = 10  $\Omega$  carbon



APPLICATION INFORMATION (continued)

Component lay-out and printed circuit board for 175 MHz test circuit:

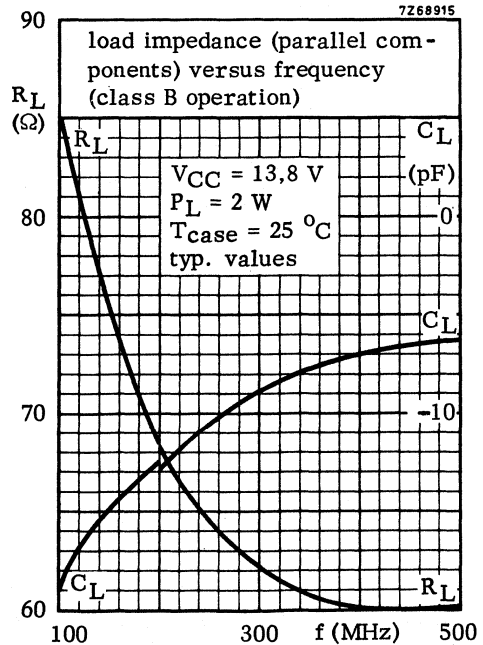
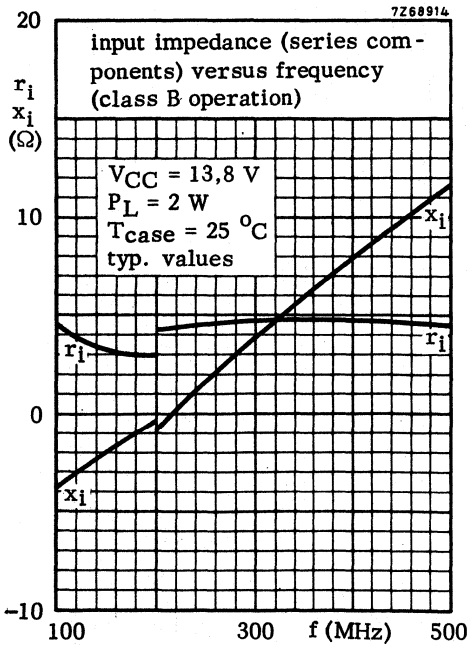
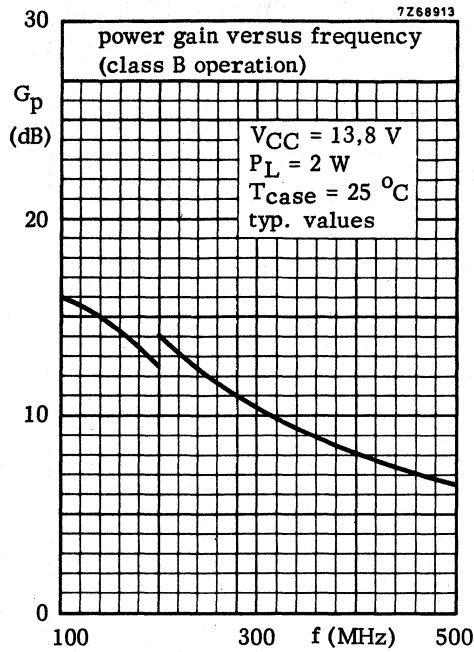


Shaded area copper

Back area not metallized

Material of printed circuit board: 1.5 mm epoxy fibre-glass

**OPERATING NOTE** Below 200 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.



## V.H.F./U.H.F. POWER TRANSISTORS

N-P-N silicon planar epitaxial transistors in TO-39 envelope designed for use in portable and mobile radio transmitters in the v.h.f. and u.h.f. bands.

### QUICK REFERENCE DATA

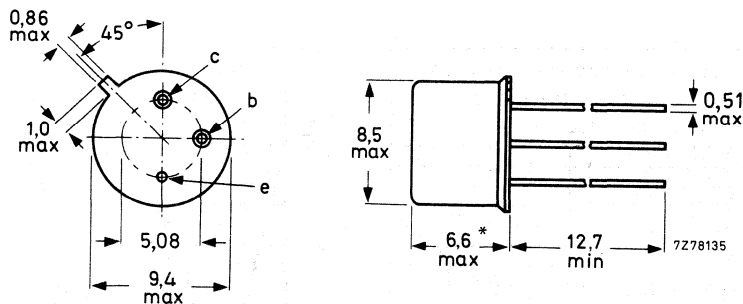
R.F. performance at  $T_c = 25^\circ\text{C}$  in a common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %
C.W.; narrow band	12,5	175	2	typ. 16	typ. 68
	12,5	470	2	$\geq 9$	$\geq 55$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-39/3.  
Emitter connected  
to case.



\* Max. 4,9 for BLX65ES.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134).

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector emitter voltage (open base)	$V_{CEO}$	max.	16 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current d.c. or average (peak value); $f \geq 1$ MHz	$I_C$ $I_{CM}$	max.	0,7 A 2,0 A
Total power dissipation at $T_{mb} \leq 90$ °C; $f \geq 1$ MHz	$P_{tot}$	max.	3,0 W
Storage temperature	$T_{stg}$		-65 to + 175 °C

**CHARACTERISTICS**

$T_j = 25$  °C unless otherwise specified

Collector-base breakdown voltage open emitter; $I_C = 10$ mA	$V_{(BR)CBO}$	>	36 V
Collector-emitter breakdown voltage open base; $I_C = 25$ mA	$V_{(BR)CEO}$	>	16 V
Emitter-base breakdown voltage open collector; $+I_E = 1,0$ mA	$V_{(BR)EBO}$	>	4 V
Collector-emitter saturation voltage $I_C = 100$ mA; $I_B = 20$ mA	$V_{CEsat}$	typ.	0,1 V
D.C. current gain $I_C = 100$ mA; $V_{CE} = 5$ V	$h_{FE}$	> typ.	10 40
Transition frequency at $f = 500$ MHz $-I_E = 200$ mA; $V_{CB} = 5$ V	$f_T$	typ.	1,4 GHz
Collector capacitance at $f = 1$ MHz $I_E = i_e = 0$ ; $V_{CB} = 10$ V	$C_c$	typ.	6,5 pF

## APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter circuit; class B);  $T_c = 25\text{ }^\circ\text{C}$ 

$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta_C$ %	$Z_i$ $\Omega$	$Z_L$ $\Omega$
9,6	175	2,0	typ. 13	typ. 68	—	—
12,5	175	2,0	typ. 16	typ. 68	—	—
12,5	470	2,0	$\geq 9$	$> 55$	$3 + j8$	$12 - j17$
12,5	470	2,0	typ. 10,6	typ. 68	—	—

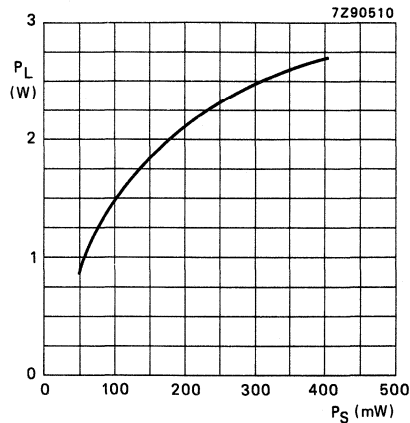


Fig. 2 Load power vs. source power;  $V_{CE} = 12,5\text{ V}$ ;  $f = 470\text{ MHz}$ ;  
 $T_{mb} = 25\text{ }^\circ\text{C}$ ; class-B operation; typical values.

## RUGGEDNESS

The device is capable of withstanding a full load mismatch ( $V_{SWR} = 50$ ; all phases) at rated load power up to a supply voltage of  $15,0\text{ V}$ ,  $P_S + 20\%$ ,  $f = 470\text{ MHz}$  and  $T_{mb} = 25\text{ }^\circ\text{C}$ .



## U.H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon transistor for use in class-B and C operated mobile, industrial and military transmitters with a supply voltage of 13,8 V.

It has a capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

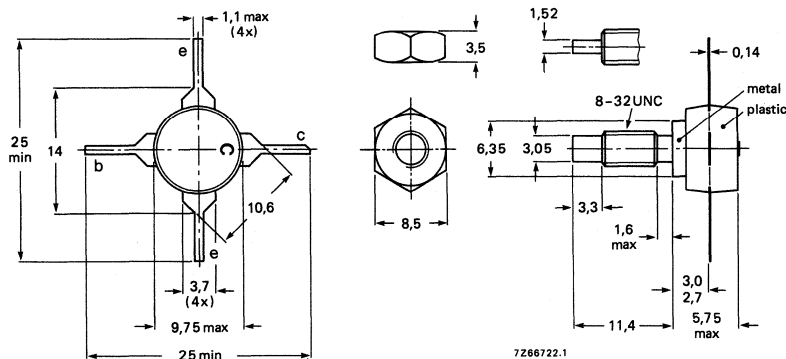
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,8	470	typ. 0,15	1,5	typ. 0,17	typ. 10	typ. 65	—	—
c.w.	13,8	470	typ. 0,35	3,0	typ. 0,28	typ. 9,3	typ. 79	$2,9 + j5,1$	$27 - j21$
c.w.	12,5	470	< 0,35	2,5	< 0,31	> 8,5	> 65	—	—
c.w.	12,5	175	typ. 0,03	3,0	typ. 0,29	typ. 20	typ. 84	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/3



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System(IEC134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36	V
Collector-emitter voltage ( $R_{BE} = 0$ ) peak value	$V_{CESM}$	max.	36	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4	V
Collector current (average)	$I_{C(AV)}$	max.	0.7	A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	2.0	A
Total power dissipation up to $T_h = 90$ °C $f > 10$ MHz	$P_{tot}$	max.	4.5	W
Storage temperature	$T_{stg}$	-65 to +150		°C
Junction temperature	$T_j$	max.	150	°C

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	12	K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0.6	K/W



**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage

open emitter,  $I_C = 10\text{ mA}$  $V_{(BR)CBO} > 36\text{ V}$ 

Collector-emitter voltage

 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter voltage

open base,  $I_C = 25\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base voltage

open collector,  $I_E = 1,0\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

## Collector-emitter saturation voltage

 $I_C = 100\text{ mA}; I_B = 20\text{ mA}$  $V_{CEsat}$  typ. 0,1 V

## D. C. current gain

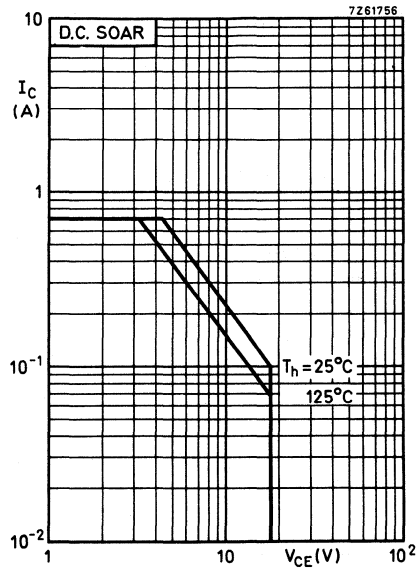
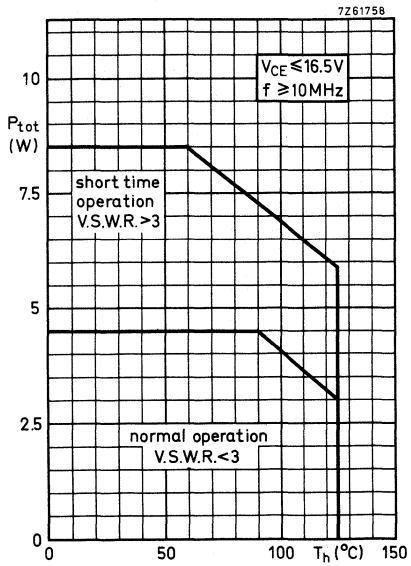
 $I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$  $h_{FE} > 10$   
typ. 40

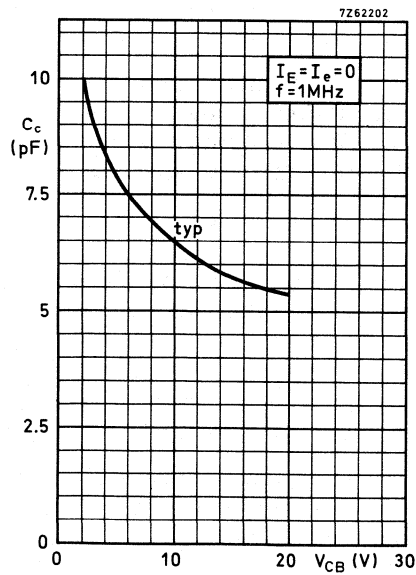
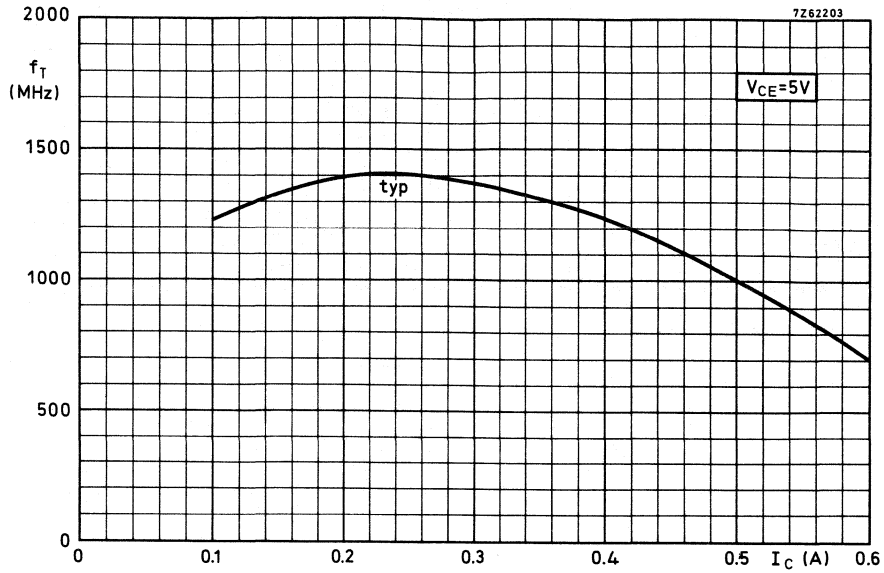
## Transition frequency

 $I_C = 0,2\text{ A}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}$  $f_T$  typ. 1400 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 10\text{ V}$  $C_c$  typ. 6,5 pF  
< 9,0 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 20\text{ mA}; V_{CE} = 10\text{ V}$  $C_{re}$  typ. 4,8 pF

## Collector-stud capacitance

 $C_{cs}$  typ. 2 pF





## APPLICATION INFORMATION

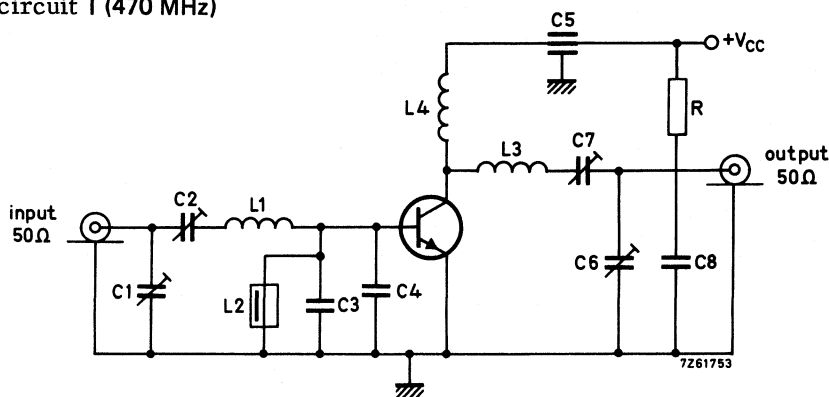
 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

R. F. performance in c. w. operation (unneutralized common-emitter class B circuit)

 $T_h$  up to  $25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CC}$ (V)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{Z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
470	13.8	typ. 0.15	1.5	typ. 0.17	typ. 10	typ. 65	-	-
470	13.8	typ. 0.35	3.0	typ. 0.28	typ. 9.3	typ. 79	$2.9 + j5.1$	$27 - j21$
470	12.5	< 0.35	2.5	< 0.31	> 8.5	> 65	-	-
175	12.5	typ. 0.03	3.0	typ. 0.29	typ. 20	typ. 84	-	-

## Test circuit I (470 MHz)



C1 = C2 = C6 = C7 = 1.8 to 18 pF film dielectric trimmer

C3 = C4 = 18 pF disc ceramic capacitor

C5 = 4 nF feed-through capacitor

C8 = 0.1  $\mu\text{F}$  polyester capacitor

L1 = 1 turn Cu wire (1.2 mm); int. diam. 6 mm; max. lead length 1 mm

L2 = 1  $\mu\text{H}$  choke

L3 = 30 mm straight Cu wire (2 mm); height above print 2 mm

L4 = 2 turns closely wound Cu wire (0.5 mm); int. diam. 3 mm; max. lead length 8 mm

R = 10  $\Omega$  carbon

At  $P_L = 2.5\text{ W}$  and  $V_{CC} = 12.5\text{ V}$ , the output power at heatsink temperatures between  $25\text{ }^\circ\text{C}$  and  $90\text{ }^\circ\text{C}$  relative to that at  $25\text{ }^\circ\text{C}$  is diminished by typ. 5 mW/K

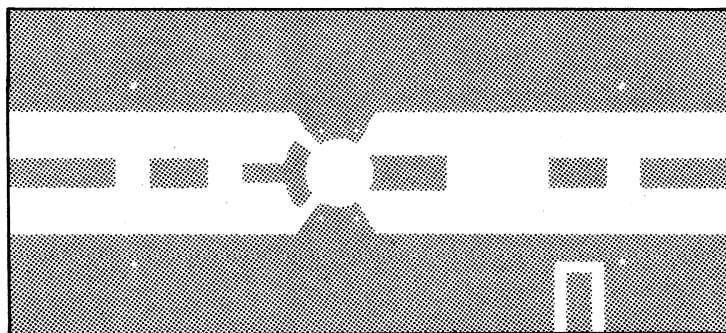
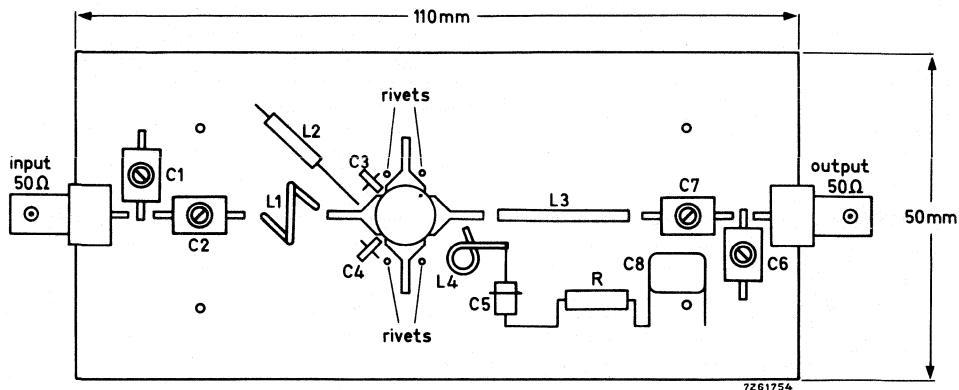
The transistor is designed to withstand full load mismatch in the test circuit under the following conditions:  $V_{CC} = 16.5\text{ V}$ ;  $f = 470\text{ MHz}$ ;  $T_h = 70\text{ }^\circ\text{C}$ ;

V. S. W. R. = 50 : 1 through all phases;  $P_S = P_{Snom} + 20\%$

where  $P_{Snom} = P_S$  for 2.5 W transistor output into 50  $\Omega$  load and  $V_{CC} = 13.8\text{ V}$

## APPLICATION INFORMATION (continued)

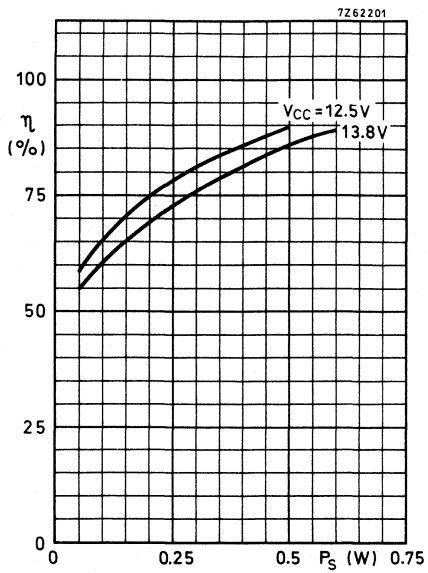
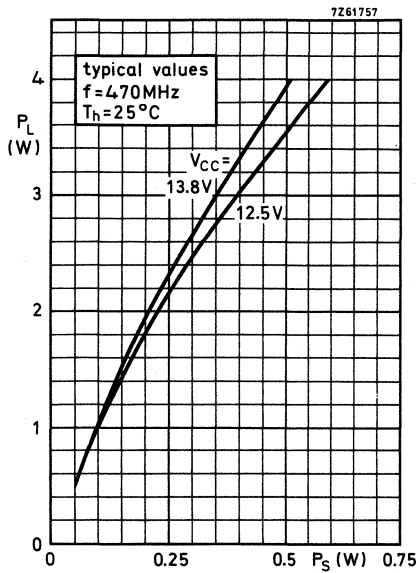
Component lay-out and printed circuit board for 470 MHz test circuit.

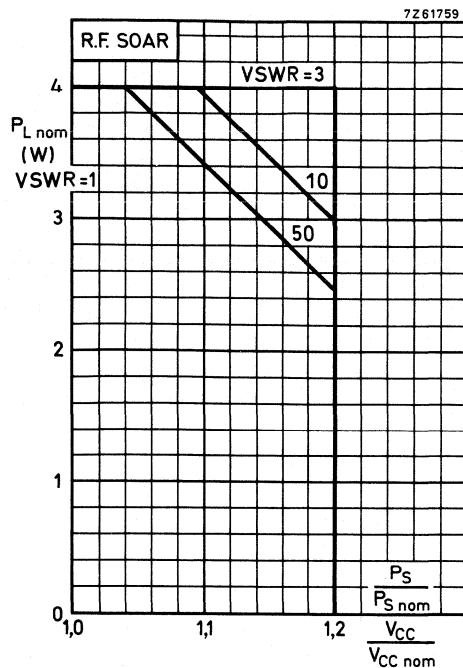


Shaded area copper

Back area completely copper clad.

Material of printed circuit board: 1,5 mm epoxy fibre glass.





Conditions for R. F. SOAR

$$f = 470 \text{ MHz}$$

$$P_{Snom} = P_S \text{ at } V_{CC} = V_{CCnom} \text{ and } VSWR = 1$$

$$T_h = 70 \text{ }^\circ\text{C}$$

$$R_{th \text{ mb-h}} = 0,6 \text{ K/W}$$

$$V_{CCnom} = 13,8 \text{ V}$$

The transistor was developed for use with unstabilized supply voltage  $V_{CC}$ .

The above graph is based on its measured performance in test circuit 1.

Supply voltage was varied from  $V_{CCnom}$  to  $1,2 V_{CCnom}$ , and VSWR from 1 to 50.

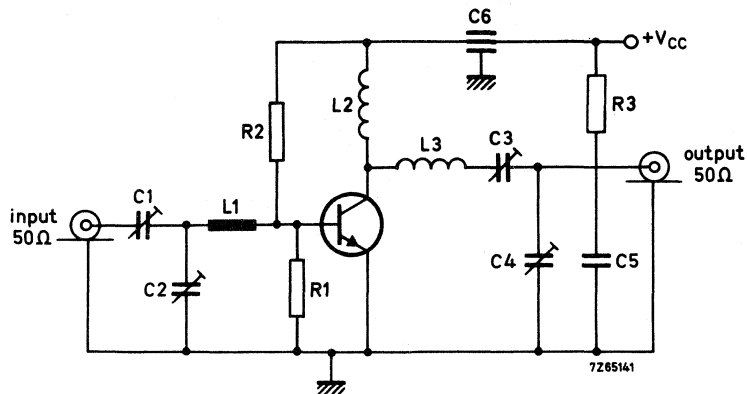
It shows the max. permissible output power under nominal conditions in order not to exceed the max. permissible power dissipation under conditions of supply over-voltage ( $V_{CC} > V_{CCnom}$ ) and load mismatch ( $VSWR > 1$ ).

It is assumed that the drive power increases linearly with the supply voltage; i. e.

$$P_S/P_{Snom} = V_{CC}/V_{CCnom}$$

## APPLICATION INFORMATION (continued)

## Test circuit II (175 MHz)



- C1 = C3 = C4 = 30 pF concentric air trimmer  
 C2 = 60 pF concentric air trimmer  
 C5 = 0.25  $\mu$ F ceramic capacitor  
 C6 = 4 nF polyester capacitor

L1 = 25 mm straight Cu wire (1.2 mm); height above print max. 3 mm

L2 = 3 turns closely wound Cu wire (1.2 mm); int. diam. 10 mm; lead length 5 mm

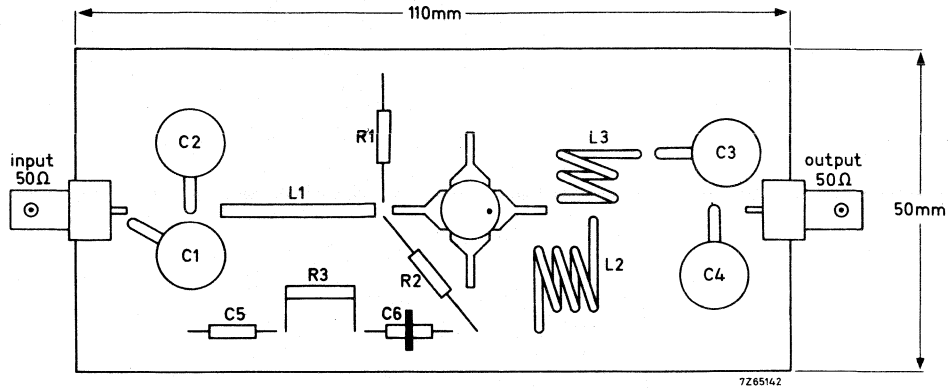
L3 = 2 turns closely wound Cu wire (1.7 mm); int. diam. 12 mm; lead length 5 mm

- R1 = 50  $\Omega$  carbon  
 R2 = 1.2 k $\Omega$  carbon  
 R3 = 5  $\Omega$  carbon

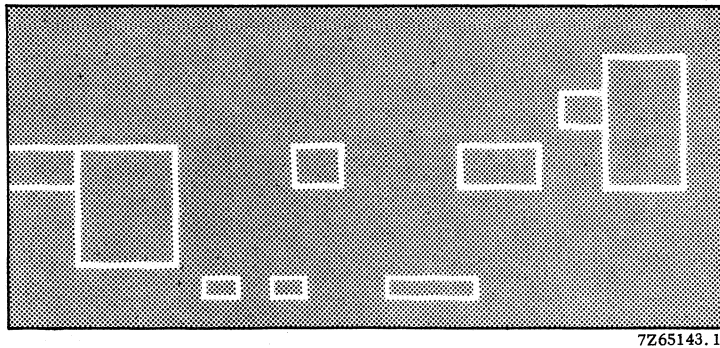


APPLICATION INFORMATION (continued)

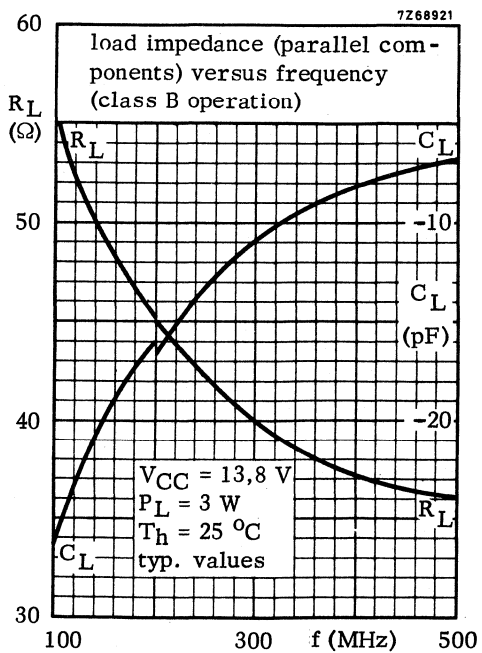
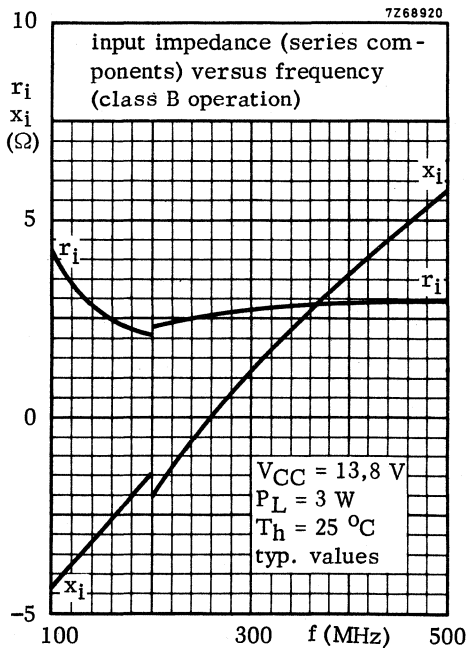
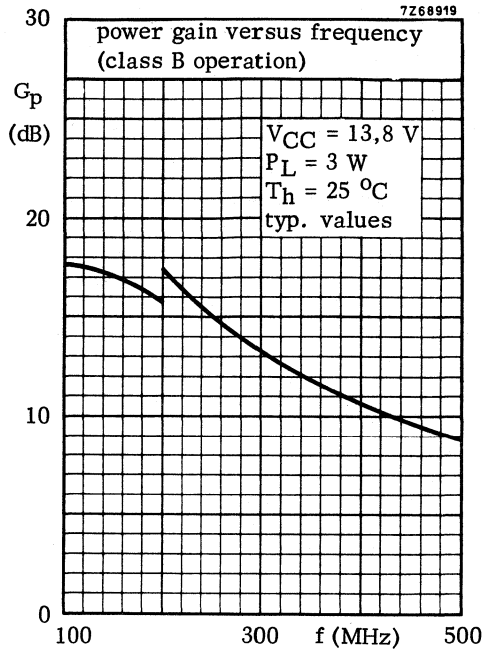
Component lay-out and printed circuit board for 175MHz test circuit.



Shaded area copper  
 Back area not metalized  
 Material of pcb : 1.5 mm epoxy fibre glass



**OPERATING NOTE** Below 200 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.



## U.H.F./V.H.F. POWER TRANSISTOR

N-P-N silicon transistor for use in class-B and C operated mobile, industrial and military transmitters with a supply voltage of 13,8 V.

It has a capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

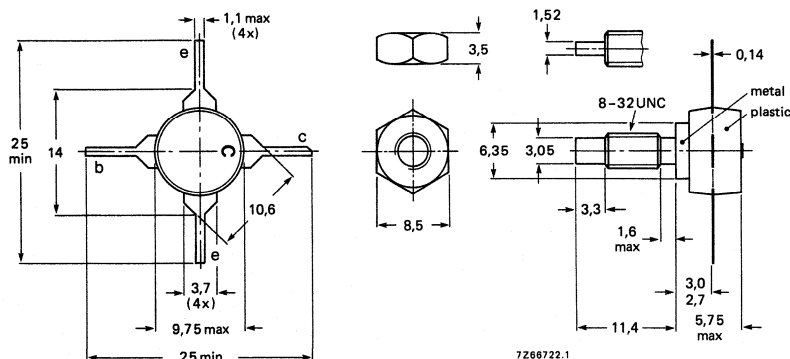
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,8	470	< 2,0	7,0	< 0,78	> 5,4	> 65	—	—
c.w.	13,8	470	typ. 2,0	7,8	typ. 0,81	typ. 5,9	typ. 70	$2,4 + j6,7$	$60 - j20$
c.w.	12,5	470	< 2,2	7,0	< 0,86	> 5,0	> 65	—	—
c.w.	12,5	175	typ. 0,4	7,2	typ. 0,87	typ. 12,6	typ. 66	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/3.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36 V
Collector-emitter voltage ( $R_{BE} = 0$ ) peak value	$V_{CESM}$	max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	1.0 A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	4.0 A
Total power dissipation up to $T_h = 70$ °C $f > 10$ MHz	$P_{tot}$	max.	10 W
Storage temperature	$T_{stg}$		-65 to +150 °C
Junction temperature	$T_j$	max.	150 °C

**THERMAL RESISTANCE**

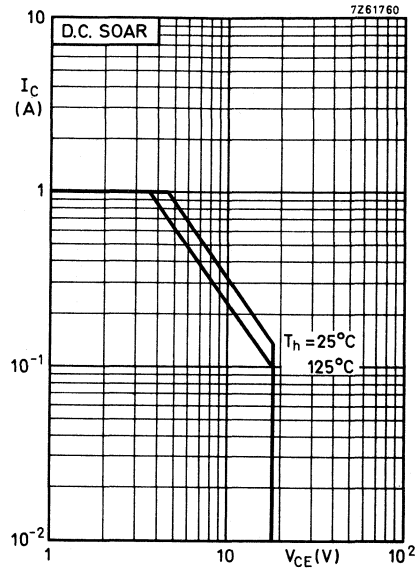
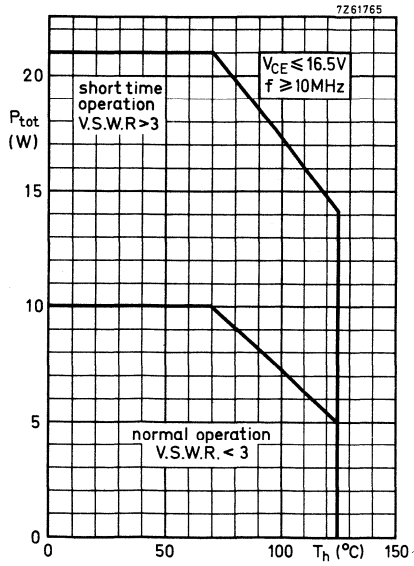
From junction to mounting base	$R_{th\ j-mb}$	=	7.0 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0.6 K/W

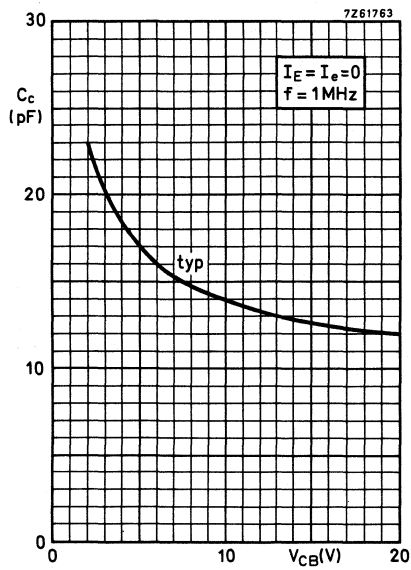
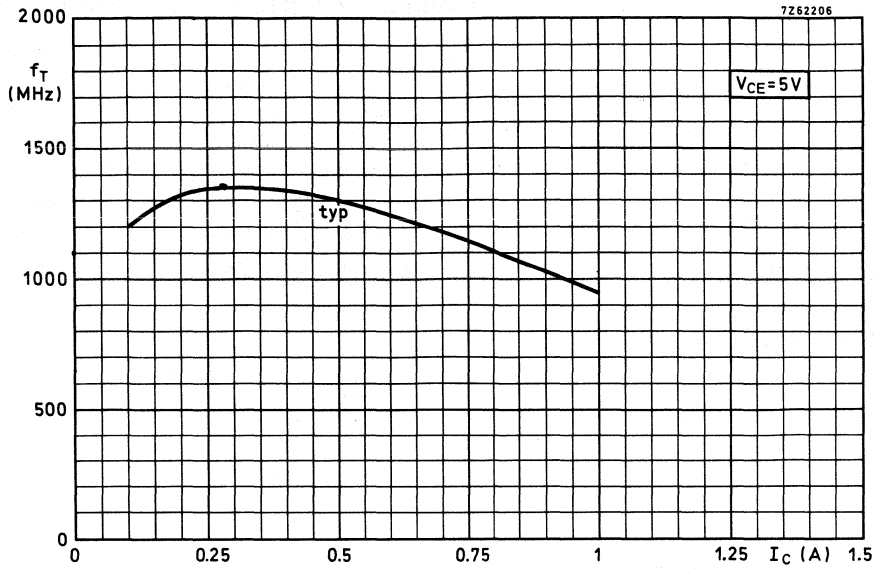
## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage open emitter, $I_C = 10\text{ mA}$	$V_{(BR)CBO}$	>	36 V
Collector-emitter voltage $V_{BE} = 0$ ; $I_C = 10\text{ mA}$	$V_{(BR)CES}$	>	36 V
Collector-emitter voltage open base, $I_C = 25\text{ mA}$	$V_{(BR)CEO}$	>	18 V
Emitter-base voltage open collector, $I_E = 1.0\text{ mA}$	$V_{(BR)EBO}$	>	4 V
Collector-emitter saturation voltage $I_C = 500\text{ mA}$ ; $I_B = 100\text{ mA}$	$V_{CEsat}$	typ.	0.2 V
D.C. current gain $I_C = 500\text{ mA}$ ; $V_{CE} = 5\text{ V}$	$h_{FE}$	> typ.	10 40
Transition frequency $I_C = 500\text{ mA}$ ; $V_{CE} = 5\text{ V}$ ; $f = 500\text{ MHz}$	$f_T$	typ.	1300 MHz
Collector capacitance at $f = 1\text{ MHz}$ $I_E = I_e = 0$ ; $V_{CB} = 10\text{ V}$	$C_c$	typ. <	14 pF 20 pF
Emitter capacitance at $f = 1\text{ MHz}$ $I_C = I_c = 0$ ; $V_{EB} = 0$	$C_e$	typ.	65 pF
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 50\text{ mA}$ ; $V_{CE} = 10\text{ V}$	$C_{re}$	typ.	10.5 pF
Collector-stud capacitance	$C_{cs}$	typ.	2 pF





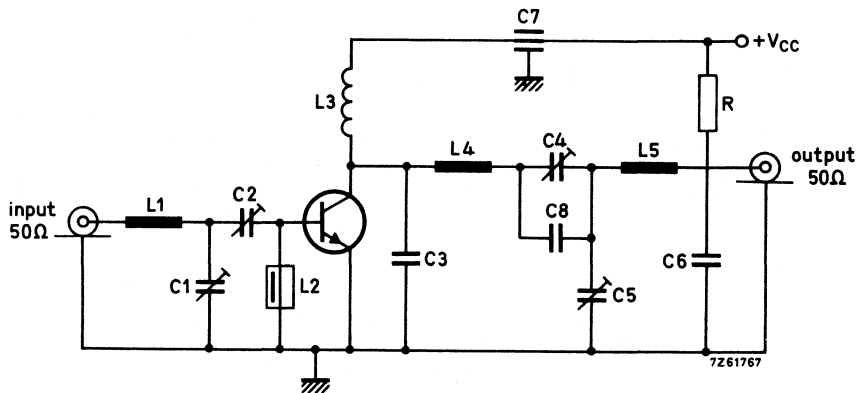
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralized common-emitter class B circuit)

 $T_h$  up to 25 °C

f (MHz)	$V_{CC}$ (V)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_D$ (dB)	$\eta$ (%)	$\bar{z}_1$ ( $\Omega$ )	$\bar{V}_L$ (mS)
470	13.8	< 2.0	7.0	< 0.78	> 5.4	> 65	—	—
470	13.8	typ. 2.0	7.8	typ. 0.81	typ. 5.9	typ. 70	$2.4 + j6.7$	$60 - j20$
470	12.5	< 2.2	7.0	< 0.86	> 5.0	> 65	—	—
175	12.5	typ. 0.4	7.2	typ. 0.87	typ. 12.6	typ. 66	—	—

Test circuit 1 (470 MHz)



C1 = C2 = C4 = C5 = 1.8 to 18 pF film dielectric trimmer

C3 = 6.8 pF ceramic capacitor

C6 = 0.1  $\mu$ F polyester capacitor

C7 = 4 nF feed-through capacitor

C8 = 10 pF ceramic capacitor

L1 = L4 = L5 = 20 mm straight Cu wire (1.2 mm); height above print 12 mm

L2 = 0.47  $\mu$ H choke

L3 = 1 turn Cu wire (1.7 mm); int. diam. 10 mm; max. lead length 5 mm

R = 10  $\Omega$  carbon

At  $P_L = 7.0$  W and  $V_{CC} = 12.5$  V the output power at heatsink temperatures between 25 °C and 90 °C relative to that at 25 °C is diminished by typ. 10 mW/K

The transistor is designed to withstand full load mismatch in the test circuit under the following conditions:  $V_{CC} = 16.5$  V;  $f = 470$  MHz;  $T_h = 70$  °C;

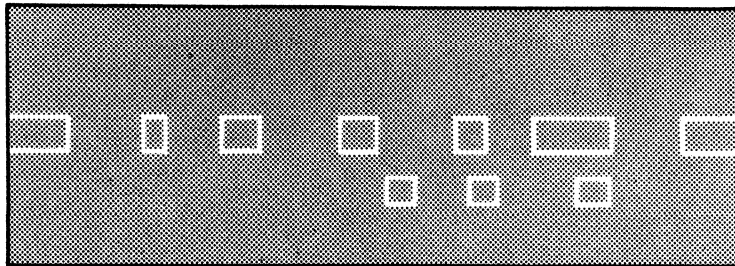
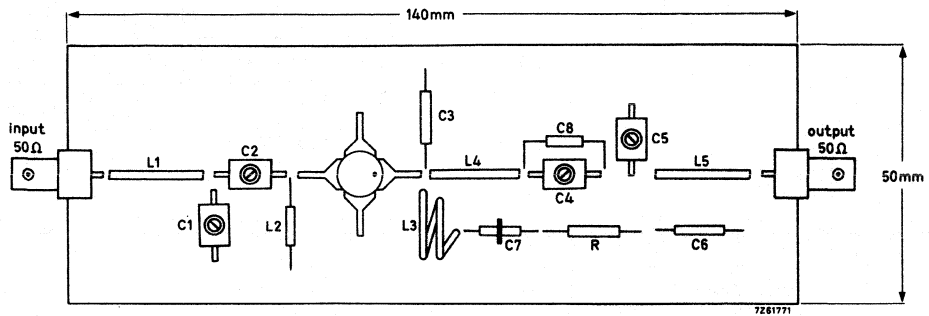
V.S.W.R. = 50 : 1 through all phases;  $P_S = P_{Snom} + 20\%$

where  $P_{Snom} = P_S$  for 7.0 W transistor output into 50  $\Omega$  load at  $V_{CC} = 13.8$  V



## APPLICATION INFORMATION (continued)

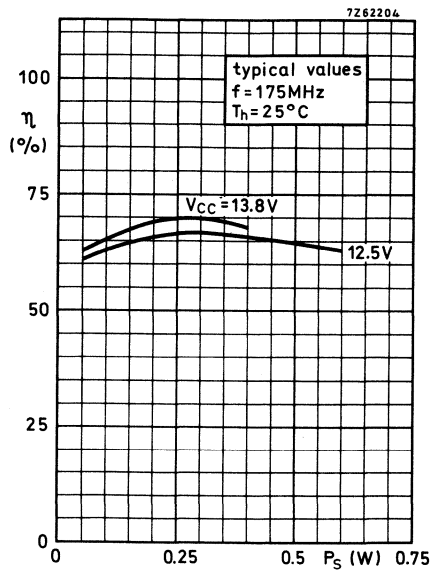
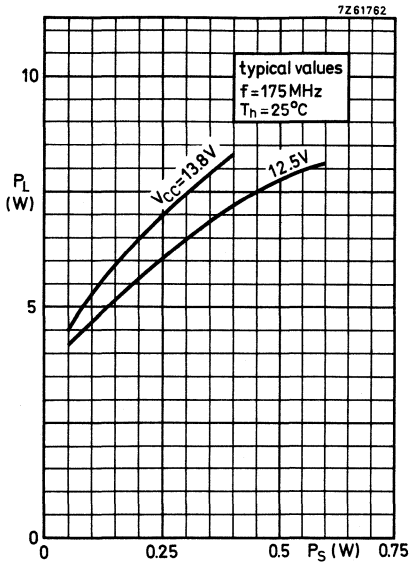
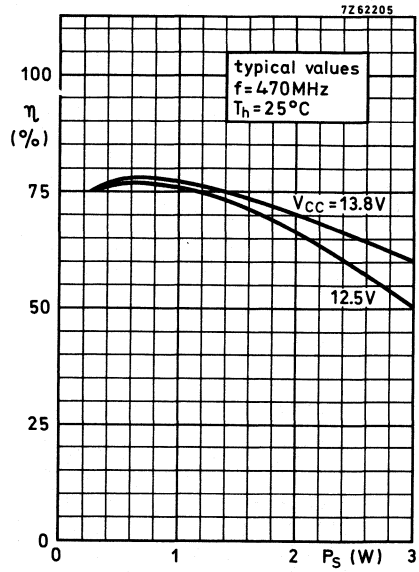
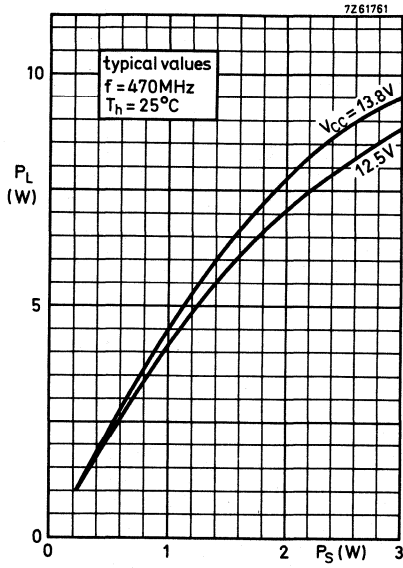
Component lay-out and printed circuit board for 470 MHz test circuit.

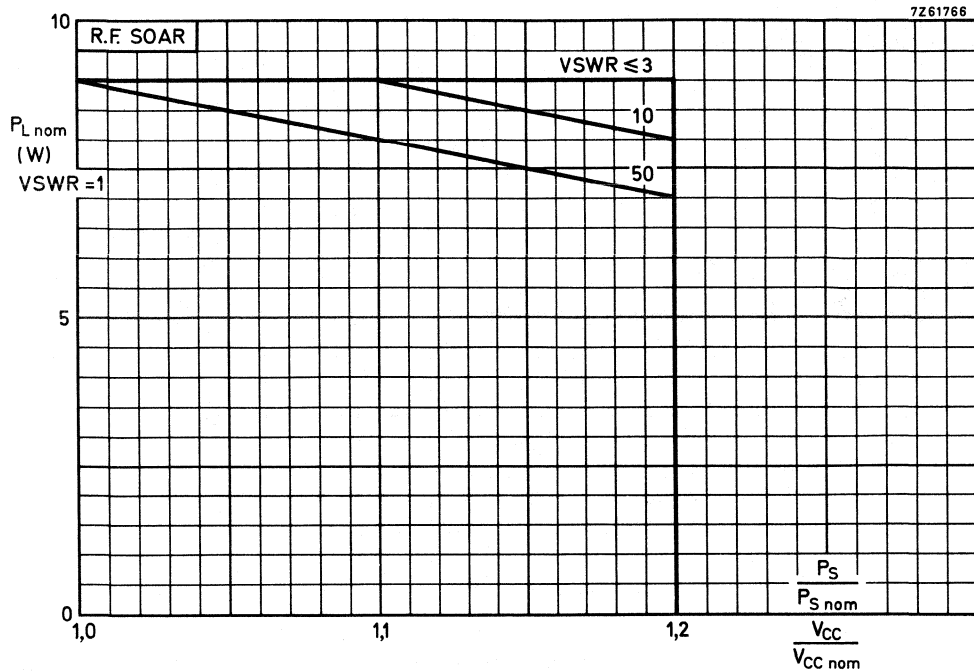


Shaded area copper

Back area completely copper clad

Material of printed circuit board: 1.5 mm epoxy fibre glass





Conditions for R. F. SOAR :

$$f = 470 \text{ MHz}$$

$$P_{Snom} = P_S \text{ at } V_{CC} = V_{CCnom} \text{ and } VSWR = 1$$

$$T_h = 70 \text{ }^\circ\text{C}$$

$$V_{CCnom} = 13.8 \text{ V}$$

The transistor was developed for use with unstabilized supply voltage  $V_{CC}$ .

The above graph is based on its measured performance in test circuit 1.

Supply voltage was varied from  $V_{CCnom}$  to  $1.2 V_{CCnom}$ , and VSWR from 1 to 50.

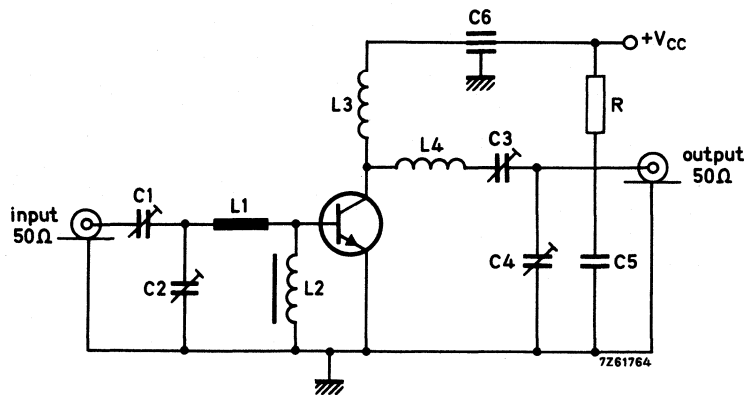
It shows the max. permissible output power under nominal conditions in order not to exceed the max. permissible power dissipation under conditions of supply over-voltage ( $V_{CC} > V_{CCnom}$ ) and load mismatch ( $VSWR > 1$ ).

It is assumed that the drive power increases linearly with the supply voltage; i. e.

$$P_S/P_{Snom} = V_{CC}/V_{CCnom}$$

## APPLICATION INFORMATION (continued)

## Test circuit II (175 MHz)



- C1 = C3 = C4 = 30 pF concentric air trimmer  
 C2 = 60 pF concentric air trimmer  
 C5 = 0.25  $\mu$ F polyester capacitor  
 C6 = 4.0 nF feed-through capacitor

L1 = 25 mm straight Cu wire (1.2 mm); height above print 3 mm

L2 = 3 turns Cu wire (0.5 mm) on Ferrite FX1115,  $d = 2$  mm,  $D = 4$  mm,  $l = 5$  mm  
material 3B (code number 3113 991 16740)

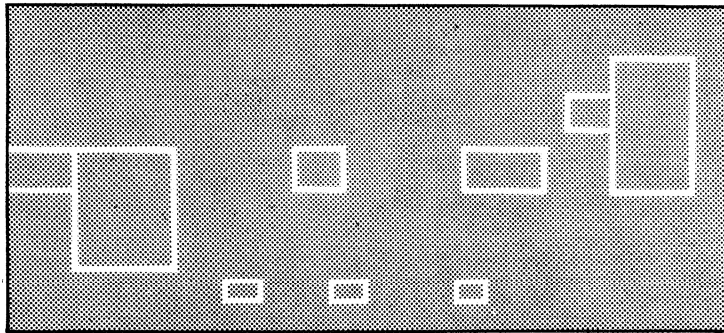
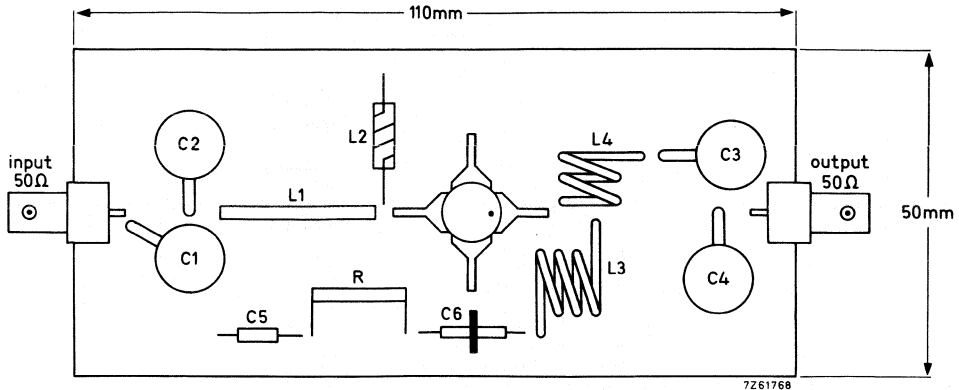
L3 = 5 turns closely wound Cu wire (1.2 mm); int. diam. 10 mm; lead length 5 mm

L4 = 3 turns closely wound Cu wire (1.2 mm); int. diam. 10 mm; lead length 5 mm

R = 10  $\Omega$  carbon

## APPLICATION INFORMATION (continued)

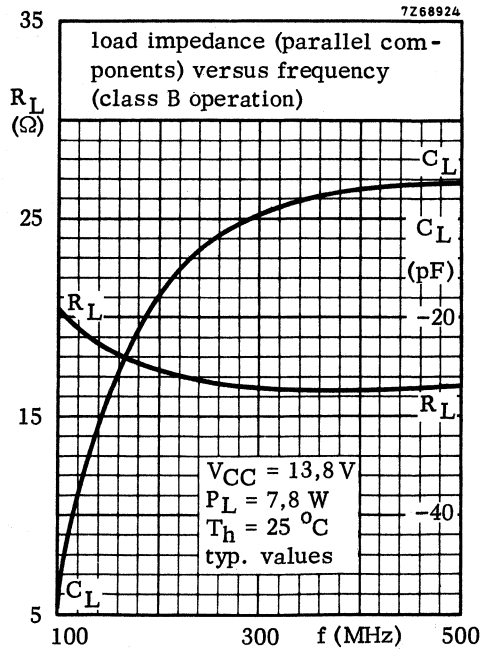
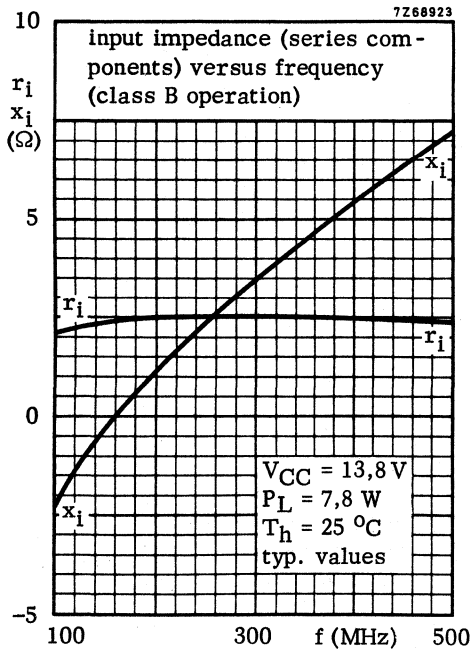
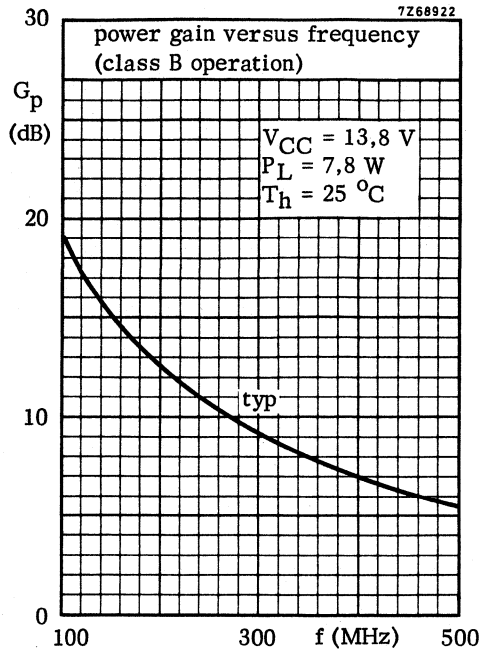
Component lay-out and printed circuit board for 175 MHz test circuit



Shaded area copper

Back area not metalized

Material of printed circuit board: 1.5 mm epoxy fibre glass



### U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V. Gold metallization ensures extremely high reliability.

It has a capstan envelope with a moulded cap. All leads are isolated from the stud.

#### QUICK REFERENCE DATA

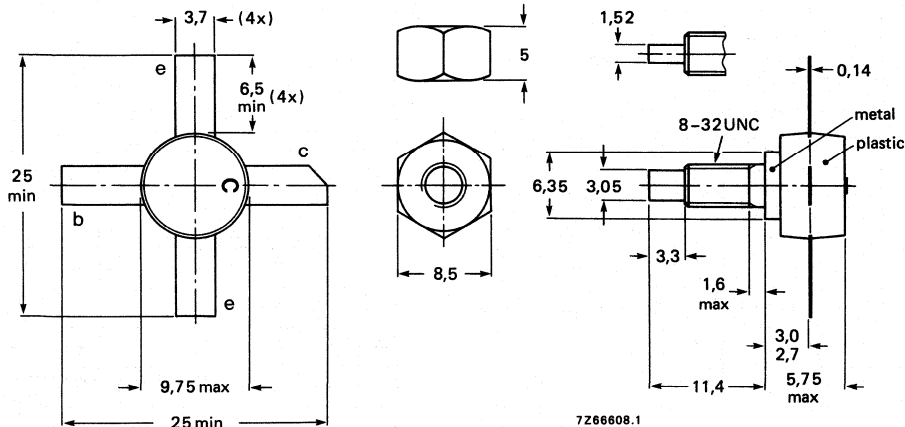
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_p$ dB	$\eta$ %	$\bar{Z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	470	< 8,0	20	< 2,28	> 4	> 65	$1,2 + j4,5$	$163 - j35$
c.w.	12,5	470	< 6,8	17	< 2,09	> 4	> 65	—	—

#### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/2.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

**Voltages**

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4	V

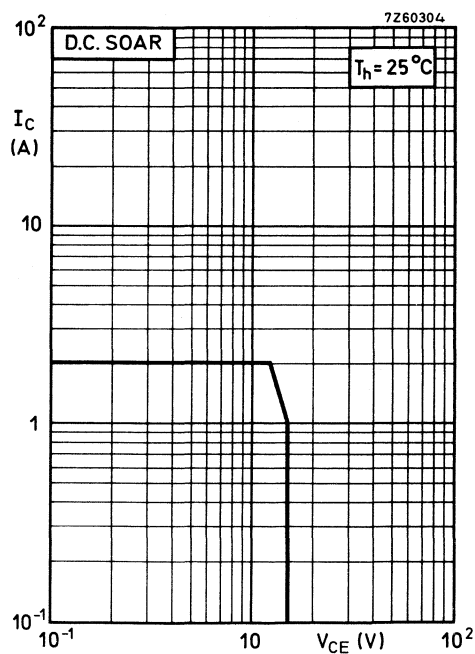
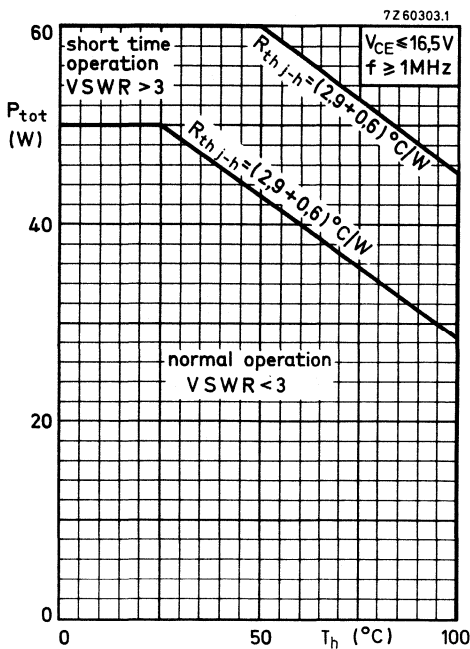
**Currents**

Collector current (average)	$I_{C(AV)}$	max.	3,5	A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	10	A

**Power dissipation**

Total power dissipation up to  $T_h = 25^\circ\text{C}$   
 $f \geq 1$  MHz

$P_{tot}$	max.	50	W
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**Temperatures**

Storage temperature	$T_{stg}$	-65 to +200	$^\circ\text{C}$
Junction temperature	$T_j$	max. 200	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	2,9	K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,6	K/W



## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

## Collector-base voltage

open emitter ;  $I_C = 25\text{ mA}$

$V_{(BR)CBO} > 36\text{ V}$

## Collector-emitter voltage

open base ;  $I_C = 25\text{ mA}$

$V_{(BR)CEO} > 18\text{ V}$

## Emitter-base voltage

open collector ;  $I_E = 10\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

## Transient energy

$L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$

open base

$E > 3,1\text{ mWs}$

$-V_{BE} = 1,5\text{ V}$ ;  $R_{BE} = 33\text{ }\Omega$

$E > 3,1\text{ mWs}$

## D.C. current gain

$I_C = 1\text{ A}$ ;  $V_{CE} = 5\text{ V}$

$h_{FE} > 10$   
typ. 30

## Transition frequency

$I_C = 2\text{ A}$ ;  $V_{CE} = 10\text{ V}$

$f_T$  typ. 1,0 GHz

Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0$ ;  $V_{CB} = 15\text{ V}$

$C_c$  typ. 55 pF  
< 70 pF

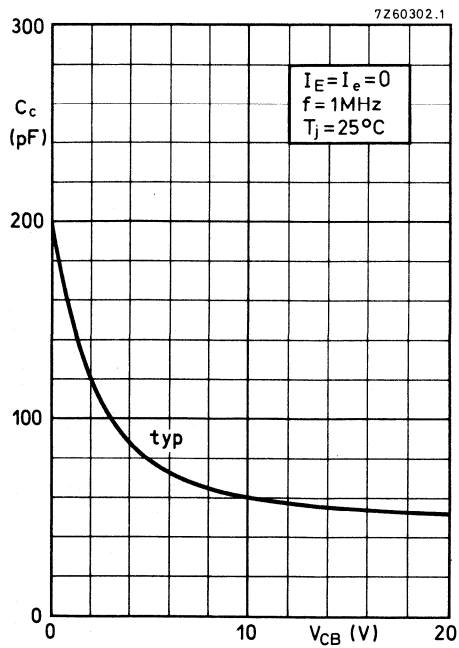
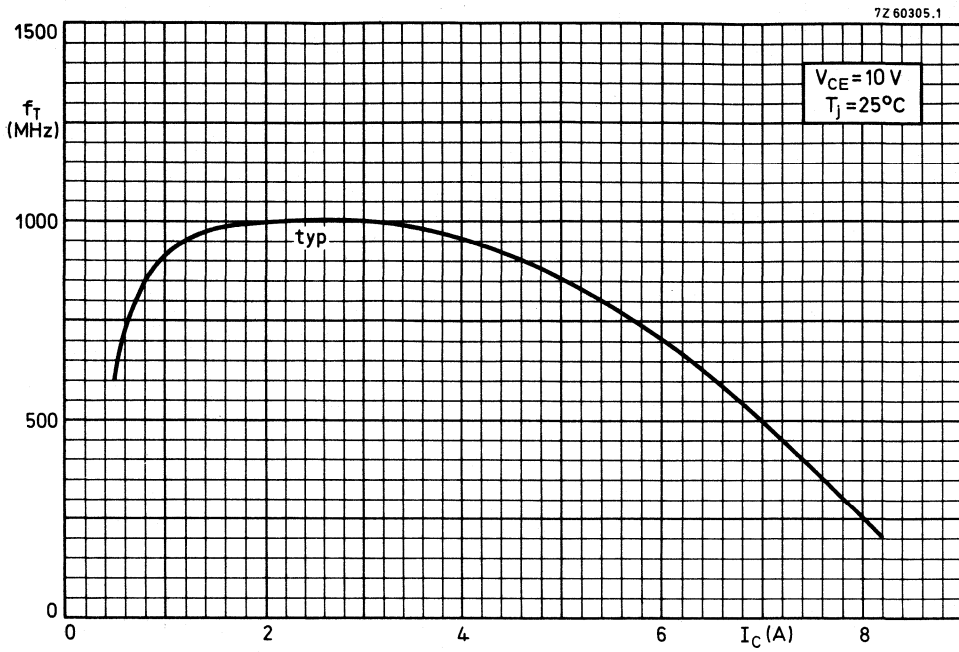
## Feedback capacitance

$I_C = 100\text{ mA}$ ;  $V_{CE} = 15\text{ V}$

$C_{re}$  typ. 32 pF

## Collector-stud capacitance

$C_{cs}$  typ. 2 pF



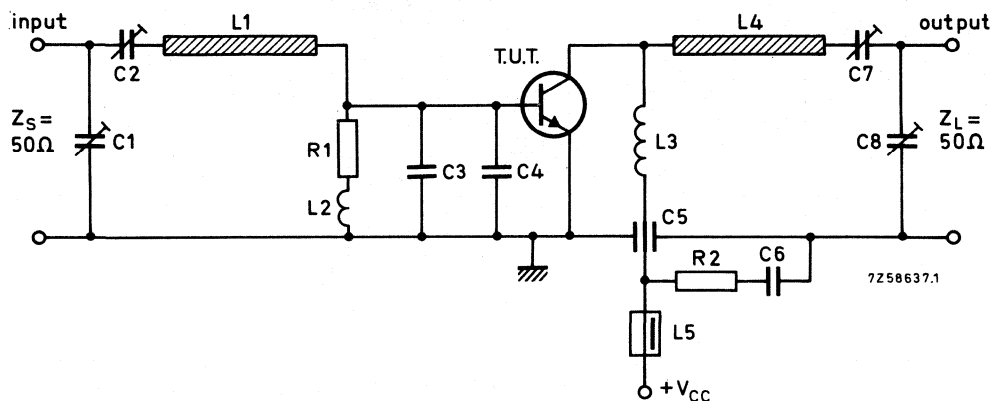
## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_{mb}$  up to 25 °C

f (MHz)	$V_{CE}$ (V)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{V}_L$ (mS)
470	13,5	< 8,00	20	< 2,28	> 4	> 65	$1,2 + j4,5$	$163 - j35$
470	12,5	< 6,80	17	< 2,09	> 4	> 65	—	—
175	12,5	typ. 1,35	17	typ. 2,30	typ. 11	typ. 60	—	—

Test circuit: 470 MHz; c.w. class-B.



## List of components:

C1 = C2 = C7 = C8 = 2,0 to 9,0 pF film dielectric trimmer (cat. no. 2222 809 09002)

C3 = C4 = 15 pF chip capacitor

C5 = 100 pF feed-through capacitor

C6 = 33 nF polyester capacitor

R1 = 1  $\Omega$  carbon resistorR2 = 10  $\Omega$  carbon resistor

L1 = stripline (41,1 mm x 5,0 mm)

L2 = 13 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 4,0 mm (0,32  $\mu$ H)

L3 = 2 turns Cu wire (1 mm); winding pitch 1,5 mm; int. dia. 4 mm; leads 2 x 5 mm

L4 = stripline (52,7 mm x 5,0 mm)

L5 = Ferroxcube choke coil. Z (at f = 50 MHz) = 750  $\Omega$   $\pm$  20% (cat. no. 4312 020 36640)

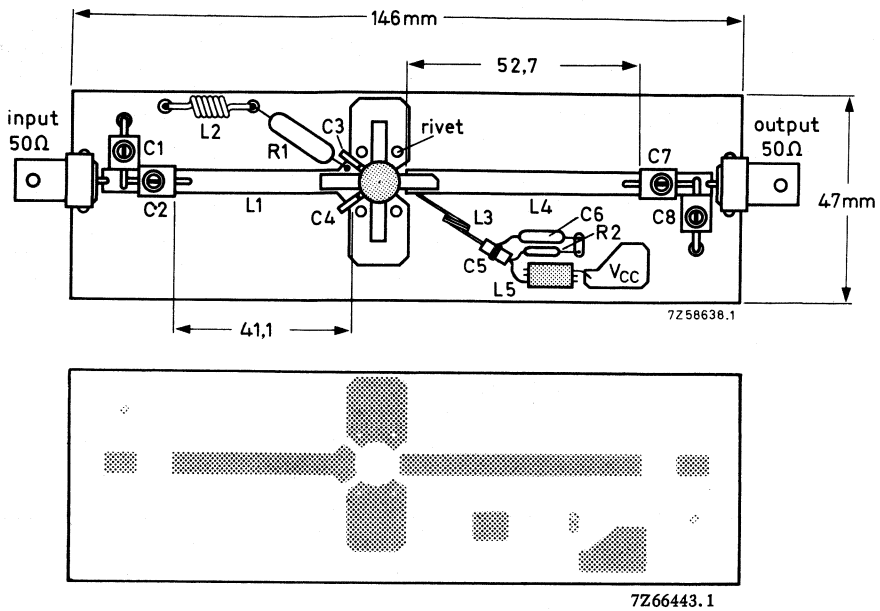
L1 and L4 are striplines on a double Cu-clad print plate with PTFE fibre-glass dielectric.

 $(\epsilon_r = 2,74)$ ; thickness 1,45 mm.

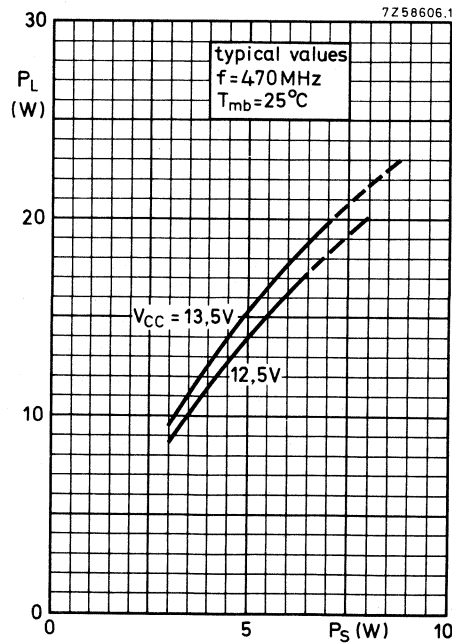
Component layout and printed-circuit board for 470 MHz test circuit see page 6.

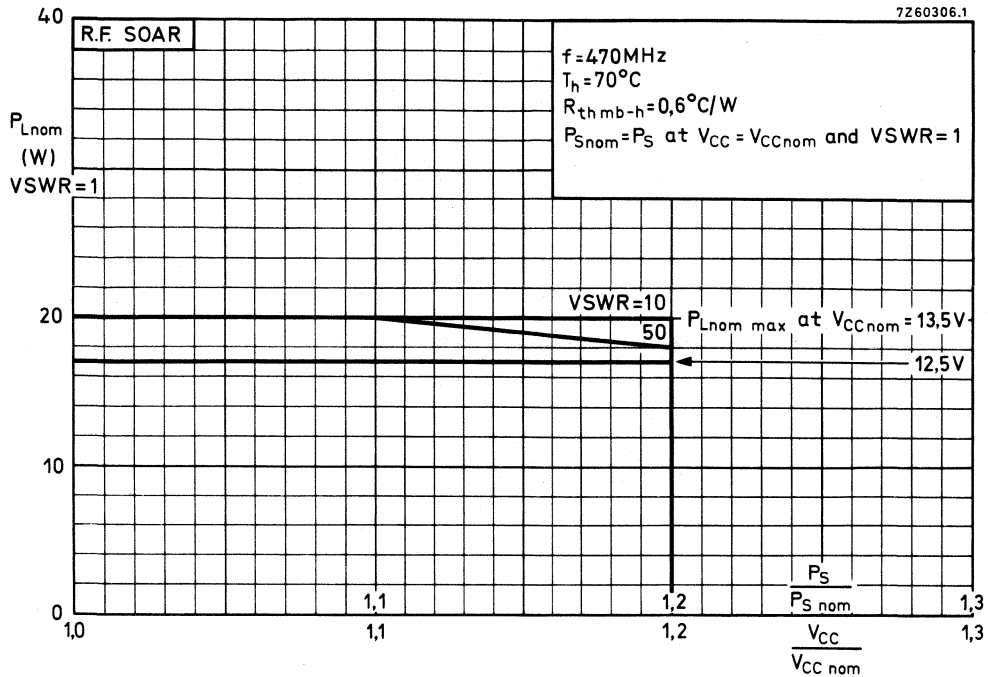
APPLICATION INFORMATION (continued)

Component layout and printed-circuit board for 470 MHz test circuit.



The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.



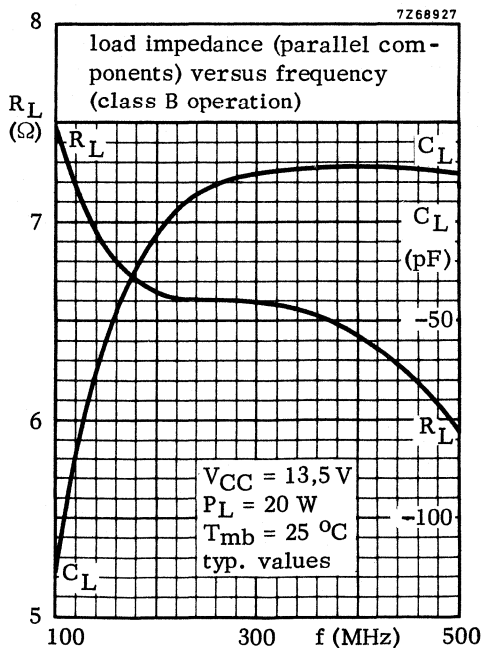
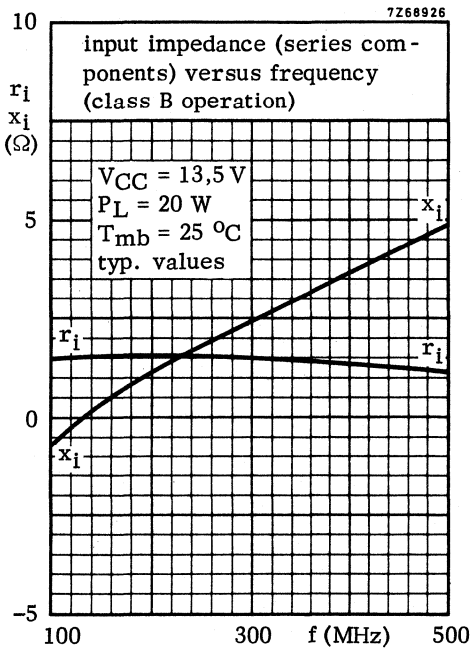
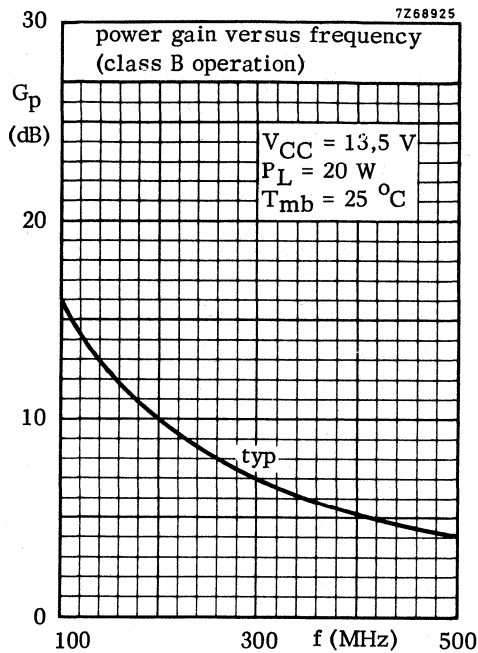


The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph above for safe operation at supply voltages other than the nominal. The graph shows the allowable output power, under nominal conditions, as a function of the supply overvoltage ratio, with VSWR as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{S\text{nom}}$ ) increases linearly with the supply overvoltage ratio.

The horizontal line at 20 W applies at  $V_{CC\text{nom}} = 13,5\text{ V}$ .

For  $V_{CC} = 12,5\text{ V}$ ,  $P_L$  should be derated to 17 W.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for transmitting applications in class-A, B or C with a supply voltage up to 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Gold metallization ensures extremely high reliability.

It has a capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

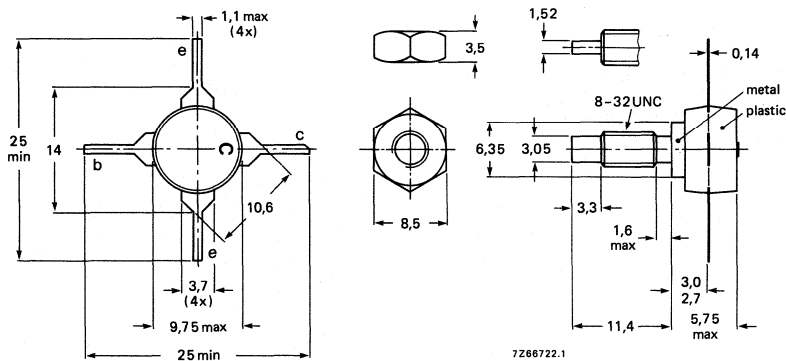
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ mW	$P_L$ W	$I_C$ mA	$G_p$ dB	$\eta$ %	$\bar{Z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	24	470	typ. 50	0,85	typ. 67	typ. 12,3	typ. 53	—	—
c.w.	28	470	< 80	1,0	< 71	> 11,0	> 50	—	—
c.w.	28	470	typ. 80	1,45	typ. 86	typ. 12,6	typ. 60	$2,5 + j0,2$	$3,4 - j16$
c.w.	28	1000	typ. 400	1,4	typ.100	typ. 5,4	typ. 50	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/3.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

## Voltages

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	65	V
Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	33	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4,0	V

## Currents

Collector current (d. c.)	$I_C$	max.	400	mA
Collector current (peak value); $f \geq 10$ MHz	$I_{CM}$	max.	800	mA

## Power dissipation

Total power dissipation up to $T_h = 70$ °C $f \geq 10$ MHz (see also page 3)	$P_{tot}$	max.	4,0	W
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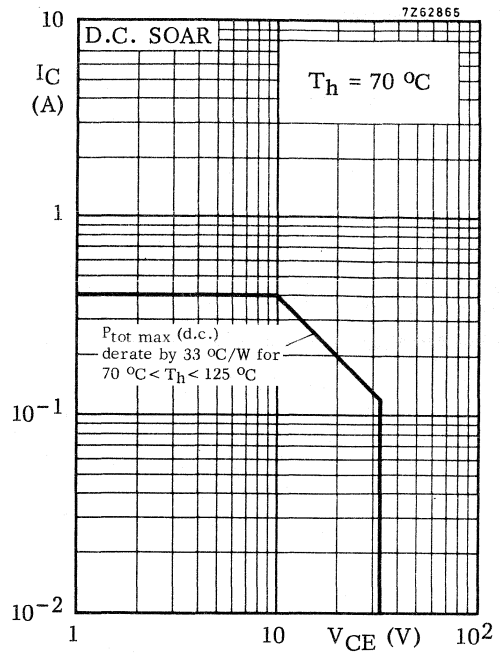
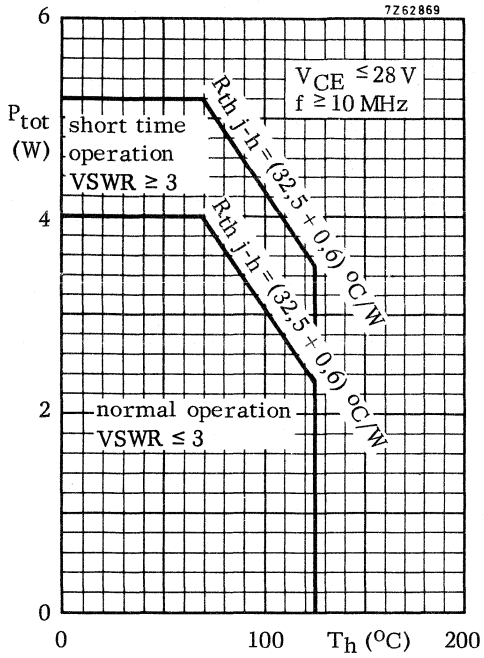
## Temperatures

Storage temperature	$T_{stg}$	-65 to +150	°C
Operating junction temperature	$T_j$	max. 200	°C

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	32,5	K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,6	K/W





**CHARACTERISTICS**

$T_j = 25^\circ\text{C}$  unless otherwise specified

Breakdown voltages

Collector-base voltage  
open emitter,  $I_C = 10\text{ mA}$

$V_{(BR)CBO} > 65\text{ V}$

Collector-emitter voltage  
 $V_{BE} = 0$ ,  $I_C = 10\text{ mA}$

$V_{(BR)CES} > 65\text{ V}$

Collector-emitter voltage  
open base,  $I_C = 25\text{ mA}$

$V_{(BR)CEO} > 33\text{ V}$

Emitter-base voltage  
open collector,  $I_E = 1,0\text{ mA}$

$V_{(BR)EBO} > 4,0\text{ V}$

D. C. current gain

$I_C = 100\text{ mA}$ ;  $V_{CE} = 5,0\text{ V}$

$h_{FE} > 10$   
typ. 35

Transition frequency

$I_C = 50\text{ mA}$ ;  $V_{CE} = 5,0\text{ V}$

$f_T$  typ. 1,2 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0$ ;  $V_{CB} = 10\text{ V}$

$C_c$  typ. 3,5 pF

Emitter capacitance at  $f = 1\text{ MHz}$

$I_C = I_c = 0$ ;  $V_{EB} = 0$

$C_e$  typ. 11 pF

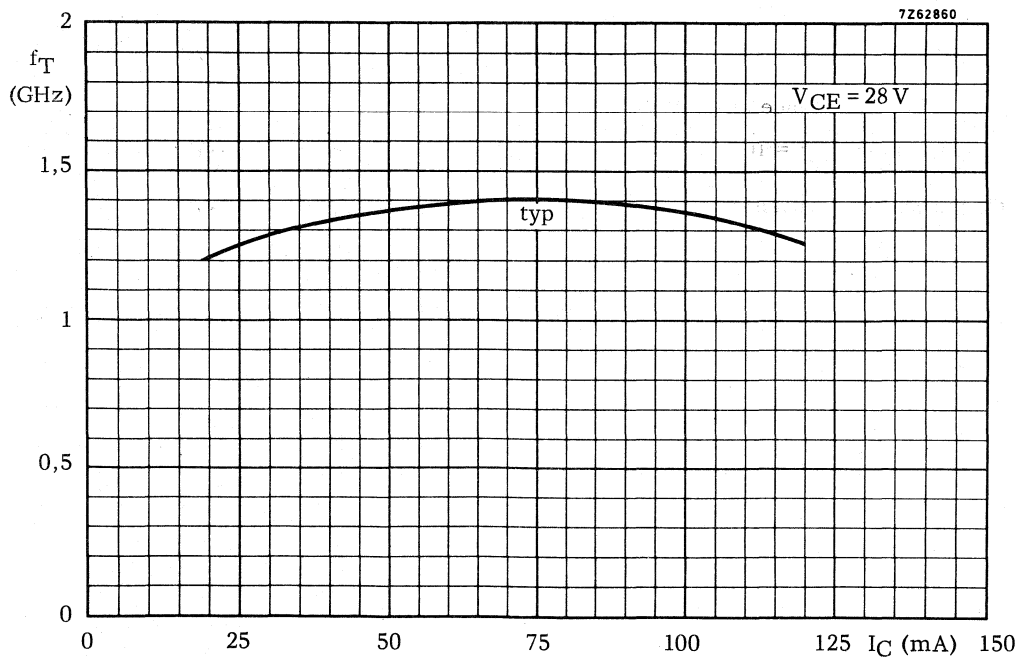
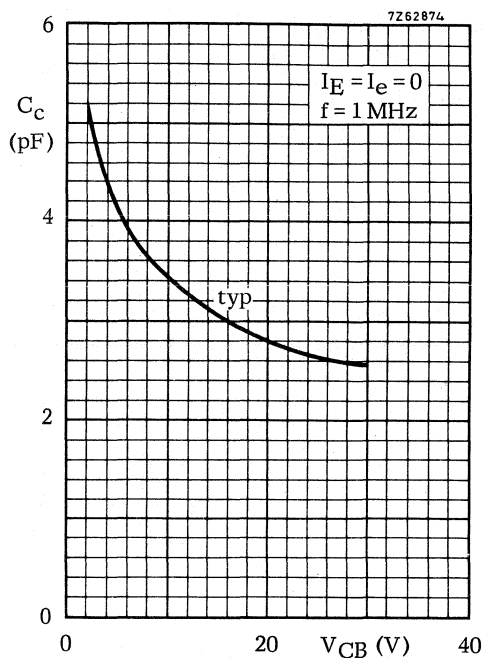
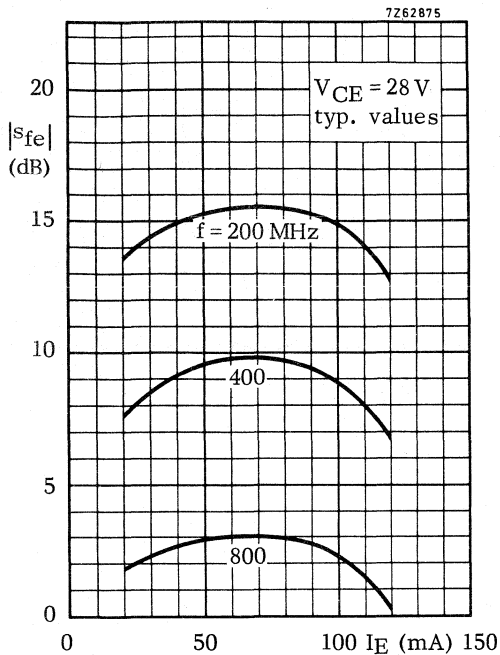
Feedback capacitance at  $f = 1\text{ MHz}$

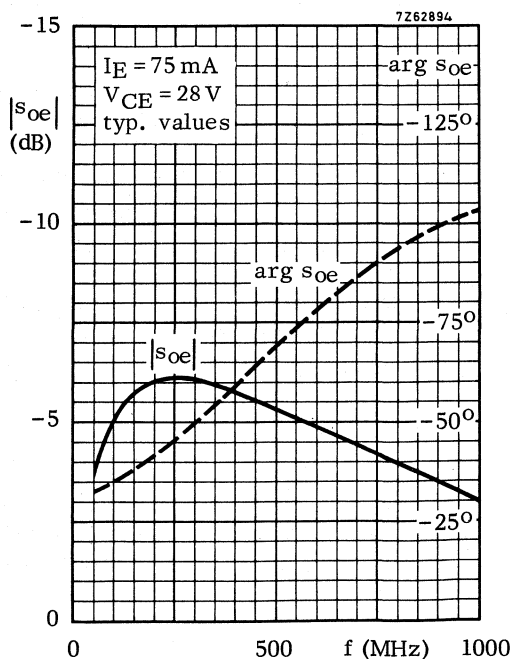
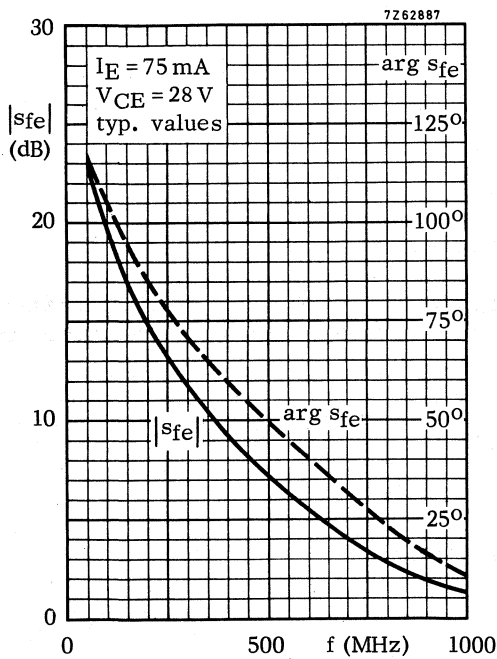
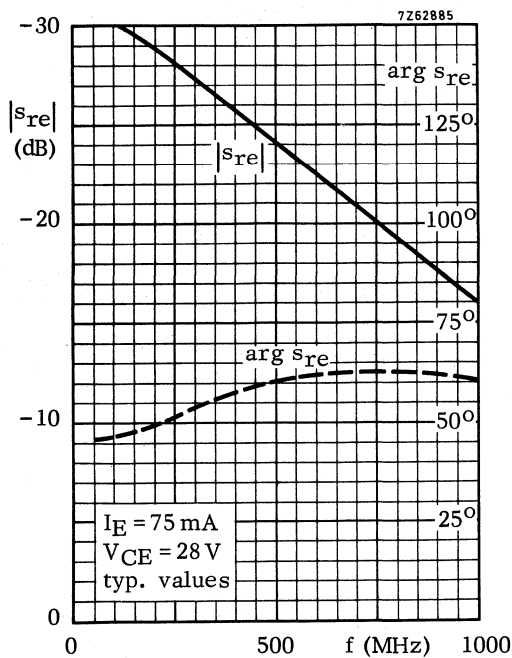
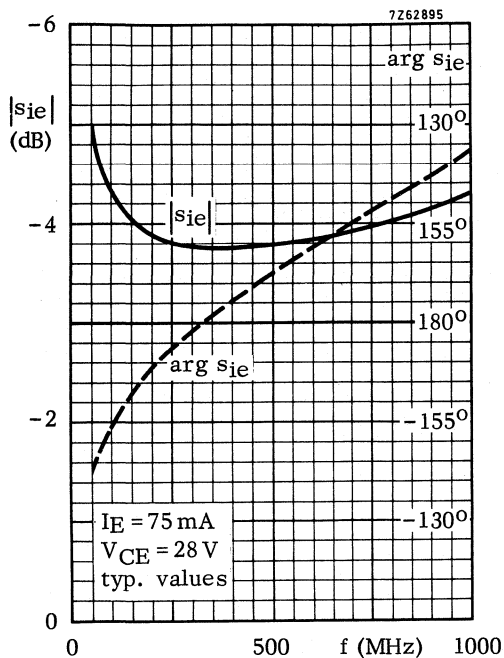
$I_C = 5\text{ mA}$ ;  $V_{CE} = 10\text{ V}$

$C_{re}$  typ. 2,5 pF

Collector-stud capacitance

$C_{cs}$  typ. 2,0 pF





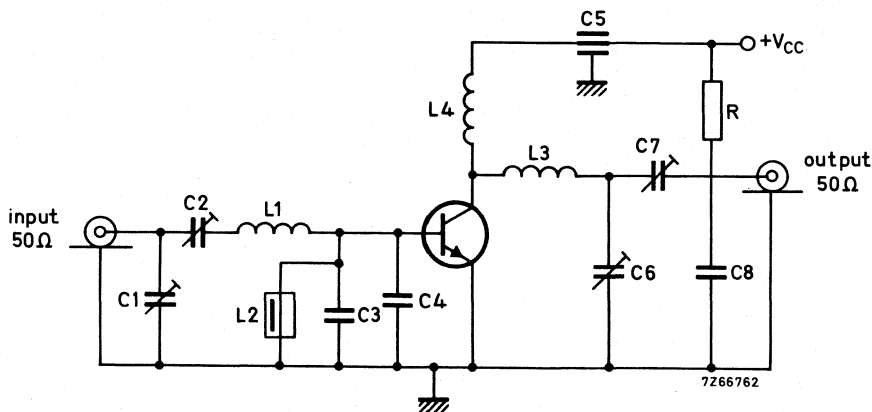
## APPLICATION INFORMATION

R. F. performance in c.w. operation (Unneutralized common-emitter class-B circuit)

$$T_h = 25 \text{ }^\circ\text{C}$$

$V_{CC}$ (V)	f (MHz)	$P_S$ (mW)	$P_L$ (W)	$I_C$ (mA)	$G_p$ (dB)	$\eta$ (%)	$\bar{Z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
24	470	typ. 50	0,85	typ. 67	typ. 12,3	typ. 53	—	—
28	470	< 80	1,0	< 71	> 11,0	> 50	—	—
28	470	typ. 80	1,45	typ. 86	typ. 12,6	typ. 60	$2,5 + j0,2$	$3,4 - j16$
28	1000	typ. 400	1,4	typ. 100	typ. 5,4	typ. 50	—	—

Test circuit for 470 MHz:



- $C1 = C2 = C7 = 1,8$  to  $18$  pF film dielectric trimmer  
 $C3 = C4 = 18$  pF disc ceramic capacitor  
 $C5 = 1$  nF feed-through capacitor  
 $C6 = 1,0$  to  $9,0$  pF film dielectric trimmer  
 $C8 = 0,1$   $\mu$ F polyester capacitor

$L1 = 1$  turn Cu wire (1,2 mm); int. dia. 5 mm; lead length = 2 mm

$L2 = 0,47$   $\mu$ H choke

$L3 = 4$  turns closely wound enamelled Cu wire (1,2 mm); int. dia. 6,5 mm; lead length = 4 mm

$L4 = 5$  turns closely wound enamelled Cu wire (0,5 mm); int. dia. 4 mm; lead length = 5 mm

$R = 10 \Omega$  carbon

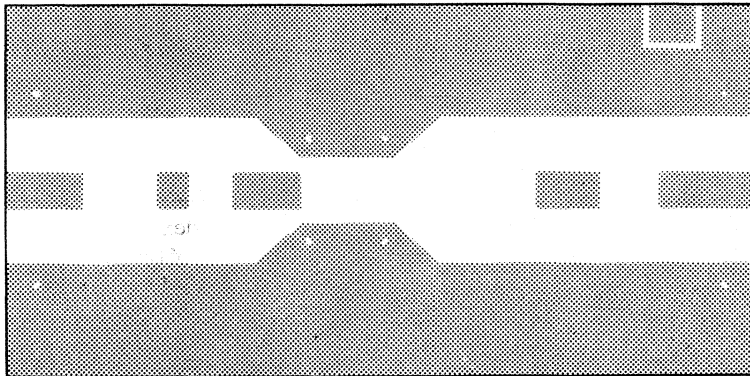
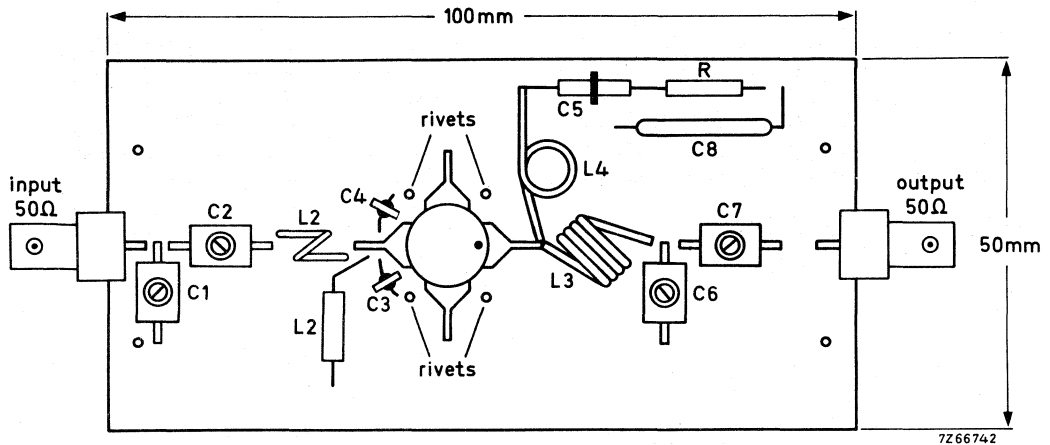
At  $P_L = 1,0$  W and  $V_{CC} = 28$  V, the output power at heatsink temperatures between  $25$   $^\circ\text{C}$  and  $90$   $^\circ\text{C}$  relative to that at  $25$   $^\circ\text{C}$  is diminished by typ. 2 mW/K

The transistor is designed to withstand full load mismatch in the test circuit under the following conditions:  $V_{CC} = 28$  V;  $f = 470$  MHz;  $T_h = 90$   $^\circ\text{C}$ .

VSWR = 50 : 1 through all phases;  $P_L = 1,2$  W.

APPLICATION INFORMATION (continued)

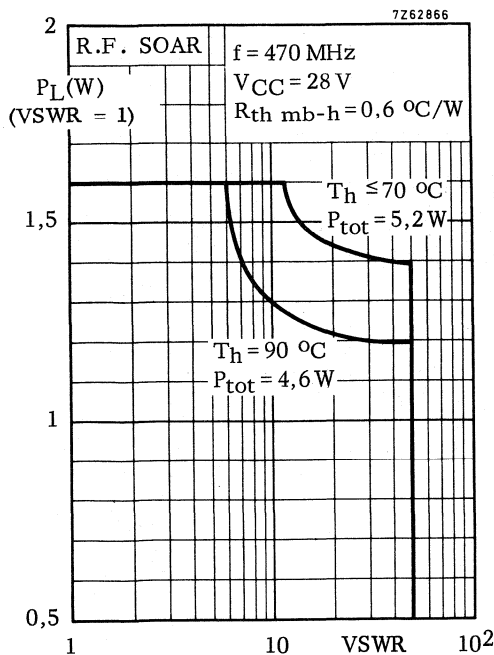
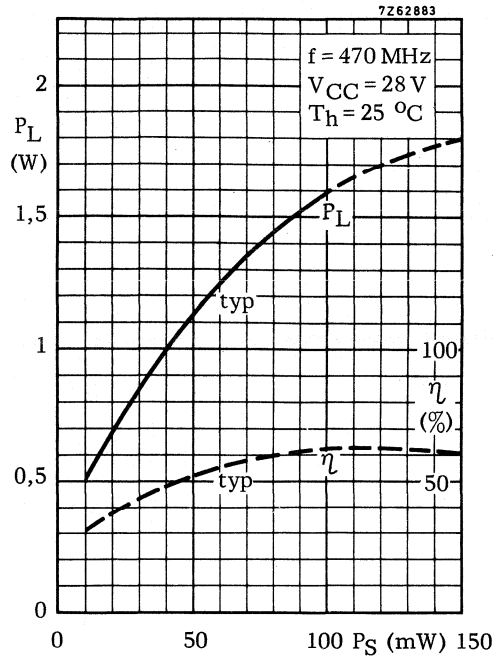
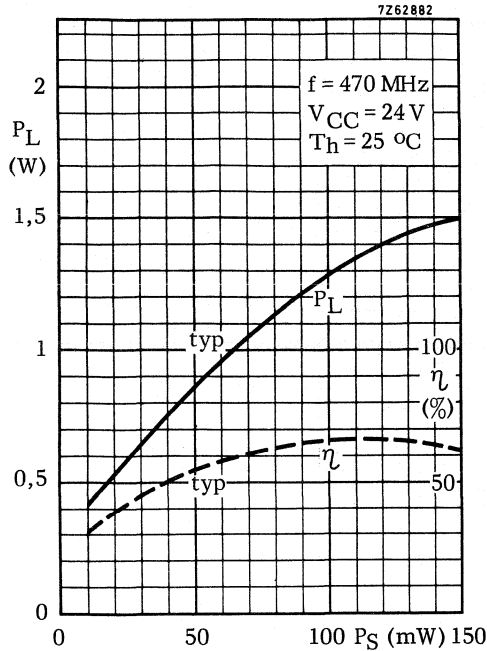
Component layout and printed-circuit board for 470 MHz test circuit.



Shaded area copper

Back area completely copper clad

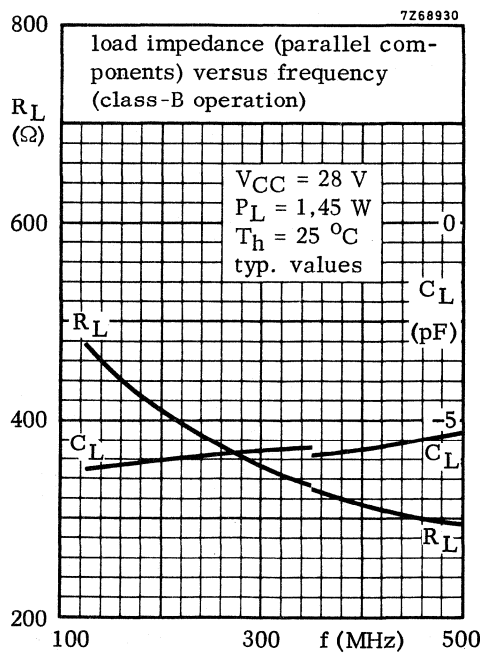
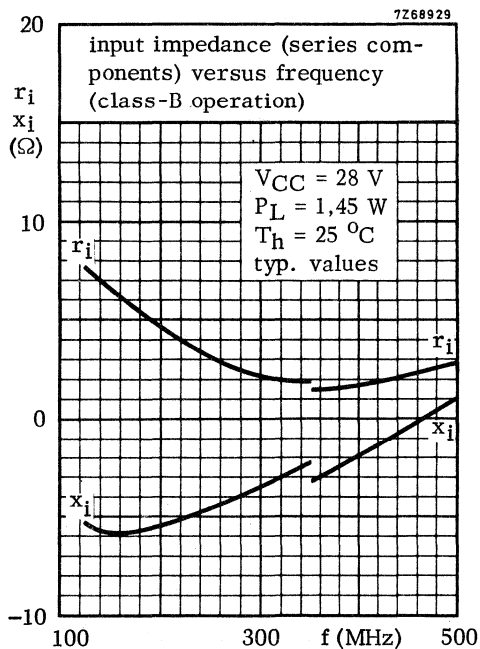
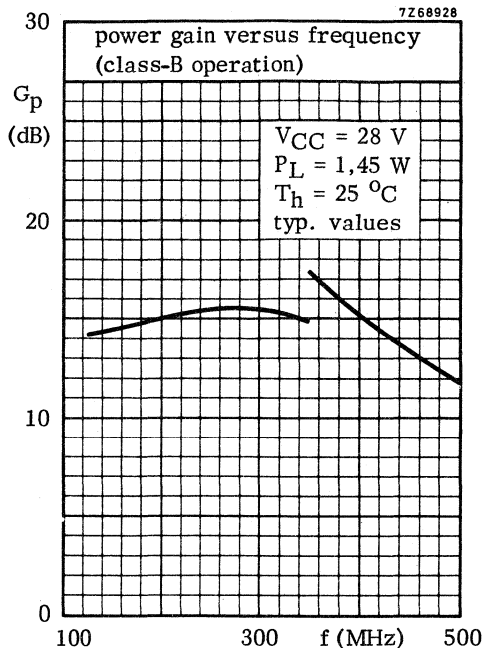
Material of printed-circuit board: 1,5 mm epoxy fibre-glass



Indicated load power as a function of overload

The graph has been derived from an evaluation of the performance of transistors matched up to 1,6 W load power in the test amplifier on page 7 and subsequently subjected to various mismatch conditions at 28 V with VSWR up to 50 and elevated heatsink temperatures. This indicates a restriction to the load power matched under nominal conditions in the recommended test configuration.

**OPERATING NOTE** Below 350 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





## SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily designed for use in fast-switching wide-band video amplifiers for driving the cathode of a picture tube.

The transistor has a common-base pin configuration and is sealed in a capstan envelope with a moulded cap. All the leads are isolated from the stud.

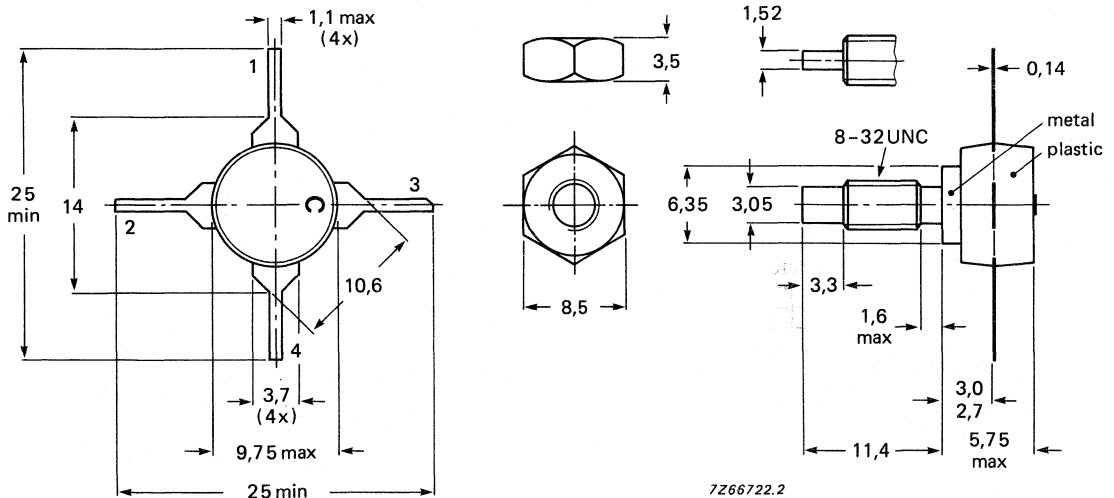
### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/3.

#### Pinning:

- 1 Base
- 2 Emitter
- 3 Collector
- 4 Base



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm  
Mounting holes to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage  
(peak value);  $V_{BE} = 0$   
open base

$V_{CESM}$	max.	65 V
$V_{CEO}$	max.	33 V

Emitter-base voltage (open collector)

$V_{EBO}$	max.	4 V
-----------	------	-----

Collector current

d.c.  
(peak value);  $f > 1$  MHz

$I_C$	max.	400 mA
$I_{CM}$	max.	800 mA

D.C. power dissipation up to  $T_h = 70$  °C  
(see D.C. SOAR in Fig. 2)

$P_{d.c.}$	max.	4 W
------------	------	-----

Storage temperature

$T_{stg}$	-65 to + 150 °C
-----------	-----------------

Operating junction temperature

$T_j$	max.	200 °C
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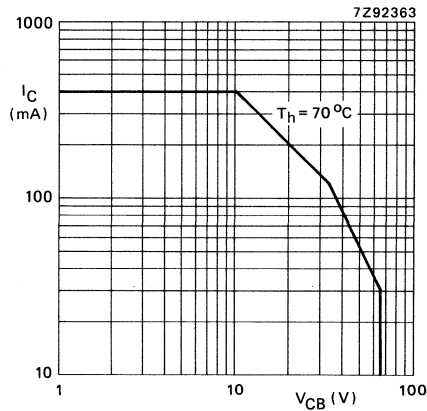


Fig. 2 D.C. SOAR.

**THERMAL RESISTANCE**

From junction to mounting base (d.c.)

$R_{th\ j-mb}$	=	32,5 K/W
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From mounting base to heatsink

$R_{th\ mb-h}$	=	0,6 K/W
----------------	---	---------

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$$V_{BE} = 0; I_C = 10\text{ mA}$$

$$I_C = 25\text{ mA}; I_B = 0$$

$$V_{(BR)CES} > 65\text{ V}$$

$$V_{(BR)CEO} > 33\text{ V}$$

Emitter-base breakdown voltage

$$I_E = 1\text{ mA}; I_C = 0$$

$$V_{(BR)EBO} > 4\text{ V}$$

Collector-base leakage current

$$V_{CB} = 20\text{ V}; I_E = 0$$

$$I_{CBO} < 1\text{ mA}$$

D.C. current gain

$$I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} \quad 10\text{ to }160$$

typ. 50

Transition frequency

$$I_C = 50\text{ mA}; V_{CE} = 5\text{ V}$$

$$f_T \quad \text{typ. } 1,0\text{ GHz}$$

Collector capacitance at  $f = 1\text{ MHz}$

$$I_E = i_e = 0; V_{CB} = 10\text{ V}$$

$$C_C \quad \text{typ. } 3,5\text{ pF}$$

Emitter capacitance at  $f = 1\text{ MHz}$

$$I_C = i_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \quad \text{typ. } 11\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$

$$I_C = 5\text{ mA}; V_{CE} = 10\text{ V}$$

$$C_{re} \quad \text{typ. } 2,5\text{ pF}$$

Collector-stud capacitance

$$C_{CS} \quad \text{typ. } 2\text{ pF}$$

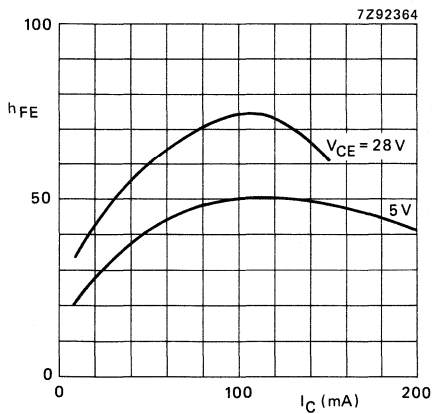


Fig. 3 Current gain (d.c.) versus collector current.

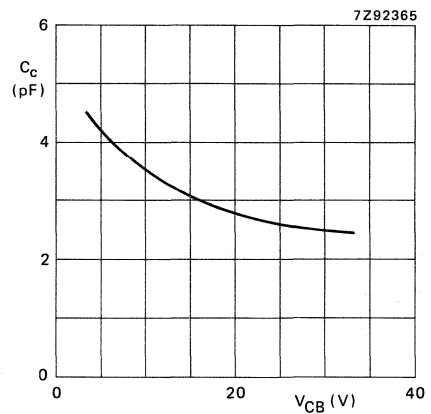


Fig. 4 Collector capacitance versus  $V_{CB}$ ;  $I_E = i_e = 0$ ;  $f = 1\text{ MHz}$ .

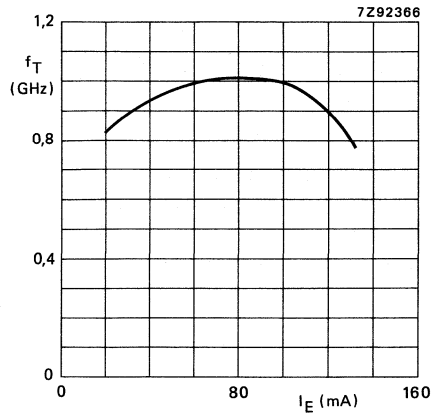


Fig. 5 Transition frequency versus emitter current;  $V_{CB} = 28$  V.

## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for transmitting applications in class-A, B or C with a supply voltage up to 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Gold metallization ensures extremely high reliability.

It has a capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

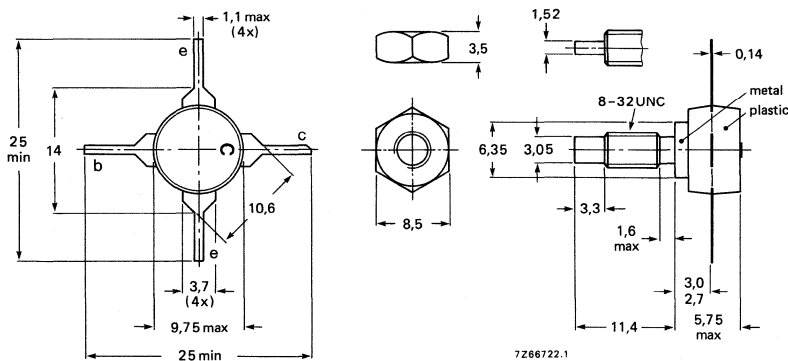
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ mA	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	24	470	typ. 0,2	2,4	typ. 143	typ. 10,8	typ. 70	—	—
c.w.	28	470	< 0,2	2,5	< 149	> 11,0	> 60	—	—
c.w.	28	470	typ. 0,2	3,0	typ. 162	typ. 11,7	typ. 66	1,8 + j2,8	7,2 - j24
c.w.	28	1000	typ. 0,7	2,5	typ. 179	typ. 5,5	typ. 50	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/3.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	65	V
Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	33	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4,0	V
Collector current (d. c.)	$I_C$	max.	0,7	A
Collector current (peak value) $f \geq 10$ MHz	$I_{CM}$	max.	2,0	A
Total power dissipation up to $T_h = 70$ °C $f \geq 10$ MHz (see also page 3)	$P_{tot}$	max.	6,0	W
Storage temperature	$T_{stg}$	-65 to +150		°C
Operating junction temperature	$T_j$	max.	200	°C

**THERMAL RESISTANCE**

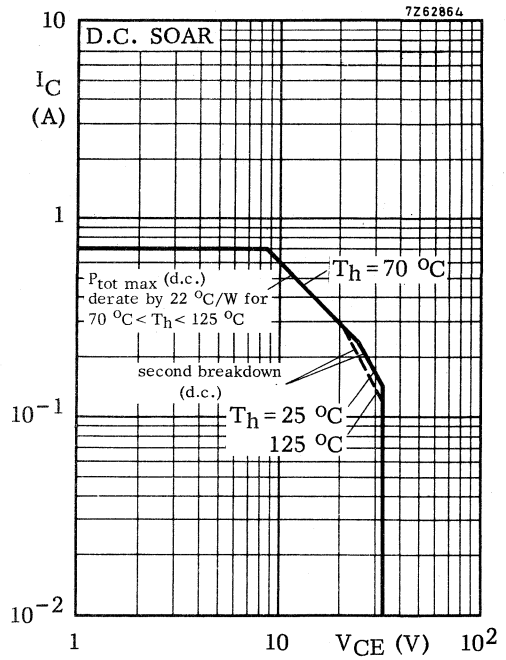
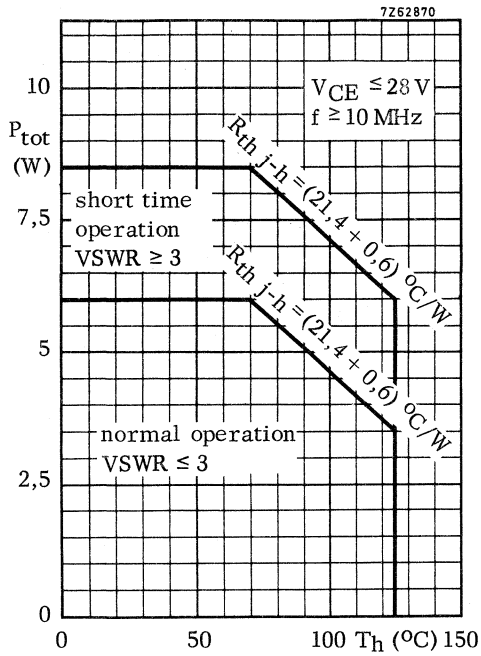
From junction to mounting base	$R_{th\ j-mb}$	=	21,4	K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,6	K/W

**CHARACTERISTICS**

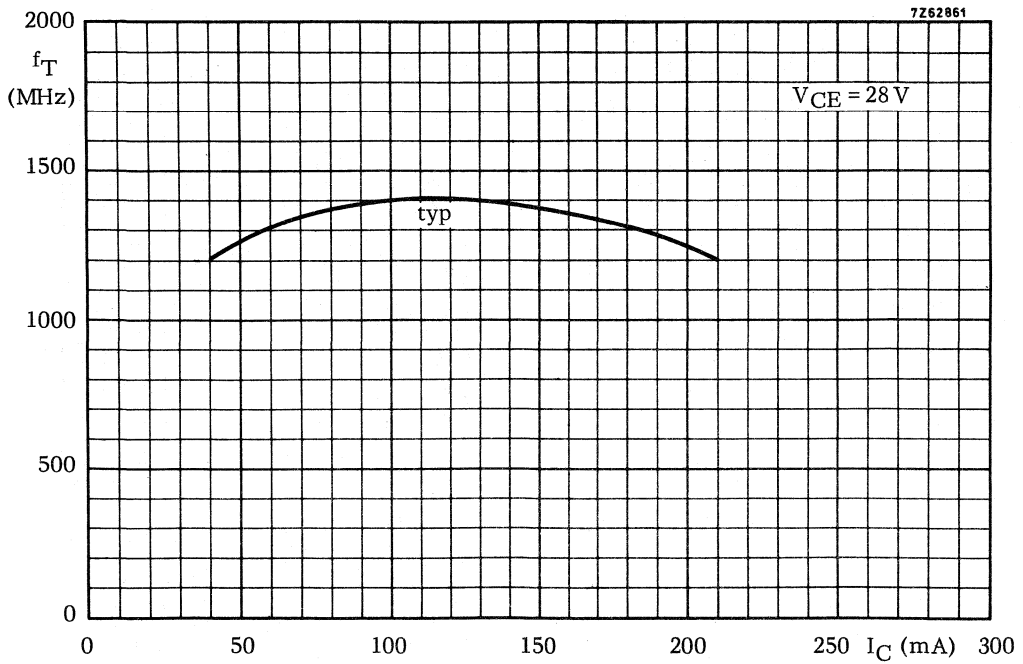
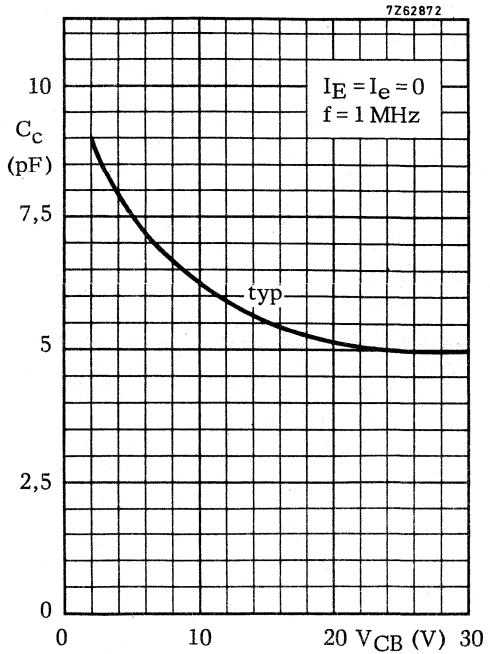
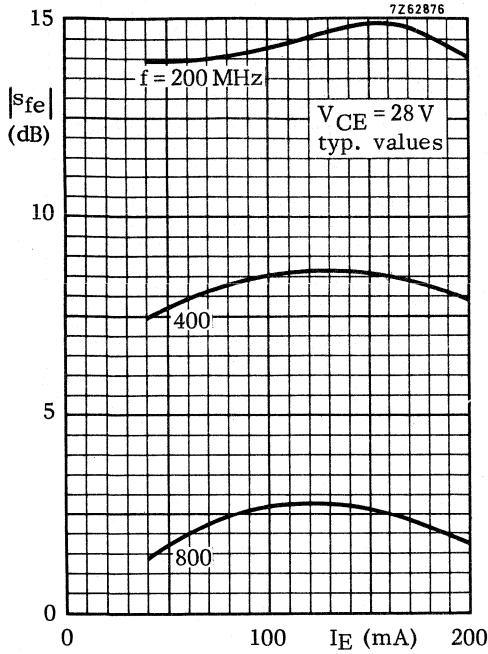
$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

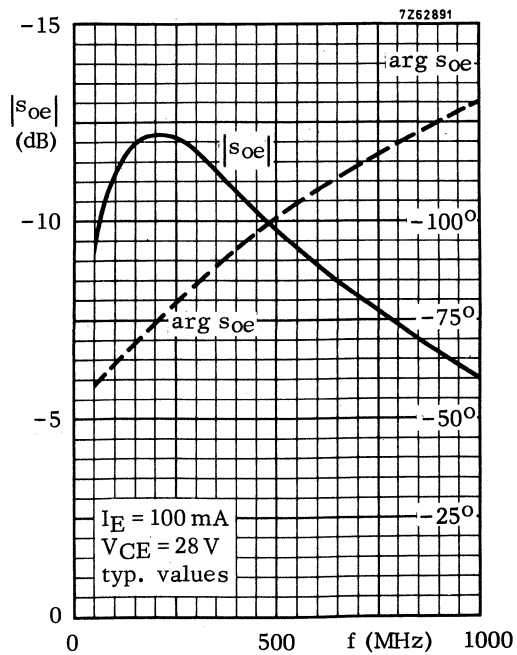
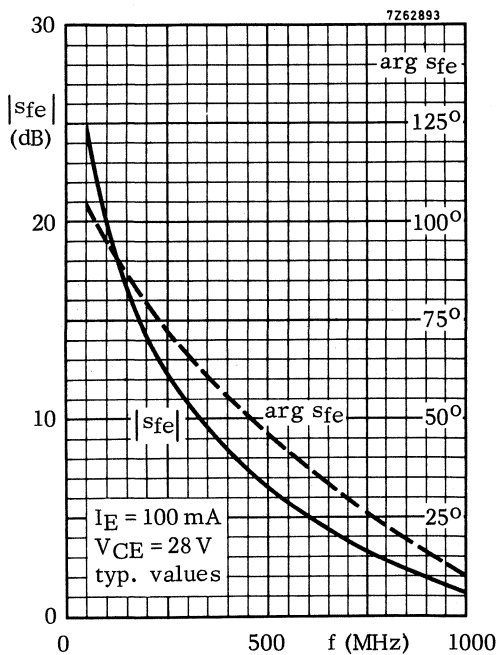
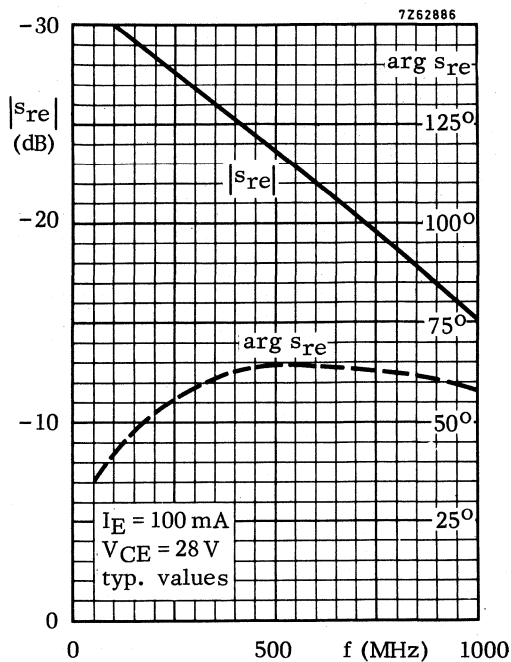
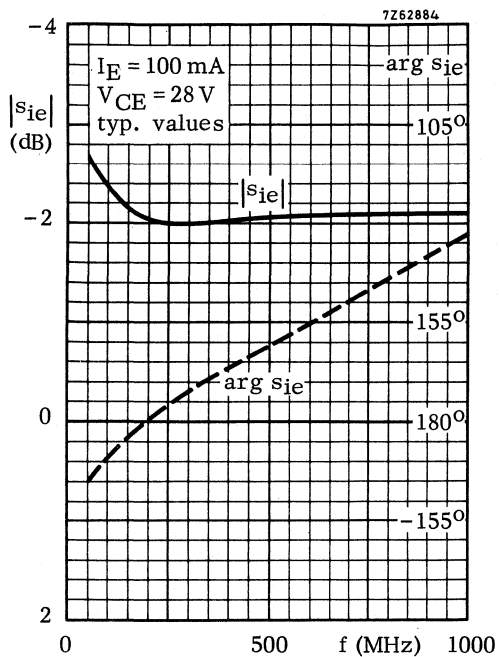
Breakdown voltages

Collector-base voltage open emitter, $I_C = 10\text{ mA}$	$V_{(BR)CBO}$	>	65	V
Collector-emitter voltage $V_{BE} = 0$ , $I_C = 10\text{ mA}$	$V_{(BR)CES}$	>	65	V
Collector-emitter voltage open base, $I_C = 25\text{ mA}$	$V_{(BR)CEO}$	>	33	V
Emitter-base voltage open collector, $I_E = 1,0\text{ mA}$	$V_{(BR)EBO}$	>	4,0	V
Collector-emitter saturation voltage $I_C = 100\text{ mA}$ ; $I_B = 20\text{ mA}$	$V_{CEsat}$	typ.	0,17	V
D. C. current gain $I_C = 100\text{ mA}$ ; $V_{CE} = 5,0\text{ V}$	$h_{FE}$	> typ.	10 40	
Transition frequency $I_C = 100\text{ mA}$ ; $V_{CE} = 5,0\text{ V}$	$f_T$	typ.	1,2	GHz
Collector capacitance at $f = 1\text{ MHz}$ $I_E = I_e = 0$ ; $V_{CB} = 10\text{ V}$	$C_c$	typ.	6,5	pF
Emitter capacitance at $f = 1\text{ MHz}$ $I_C = I_c = 0$ ; $V_{EB} = 0$	$C_e$	typ.	25	pF
Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 10\text{ mA}$ ; $V_{CE} = 10\text{ V}$	$C_{re}$	typ.	4,8	pF
Collector-stud capacitance	$C_{cs}$	typ.	2,0	pF









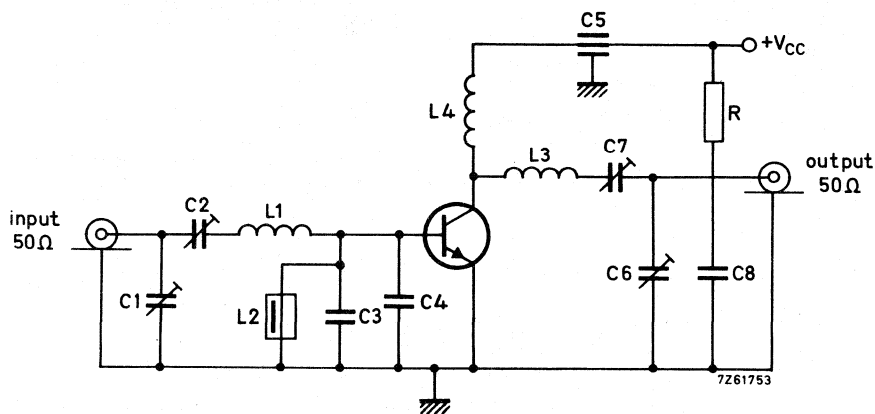
## APPLICATION INFORMATION

R. F. performance in c. w. operation (Unneutralized common-emitter class-B circuit)

$$T_h = 25 \text{ }^\circ\text{C}$$

$V_{CC}$ (V)	f (MHz)	$P_S$ (W)	$P_L$ (W)	$I_C$ (mA)	$G_p$ (dB)	$\eta$ (%)	$\bar{Z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
24	470	typ. 0,2	2,4	typ. 143	typ. 10,8	typ. 70	—	—
28	470	< 0,2	2,5	< 149	> 11,0	> 60	—	—
28	470	typ. 0,2	3,0	typ. 162	typ. 11,7	typ. 66	$1,8 + j2,8$	$7,2 - j24$
28	1000	typ. 0,7	2,5	typ. 179	typ. 5,5	typ. 50	—	—

Test circuit for 470 MHz:



C1 = C2 = 1,8 to 18 pF film dielectric trimmer

C3 = C4 = 18 pF disc ceramic capacitor

C5 = 1 nF feed-through capacitor

C6 = C7 = 1,0 to 9,0 pF film dielectric trimmer

C8 = 0,1  $\mu$ F polyester capacitor

L1 = 1 turn Cu wire (1,2 mm); int. dia. 5 mm; lead length = 2 mm

L2 = 0,47  $\mu$ H choke

L3 = 2 turns closely wound enamelled Cu wire (1,2 mm); int. dia. 6,5 mm; lead length = 4 mm

L4 = 3 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 4,0 mm; lead length = 5 mm

R = 10  $\Omega$  carbon

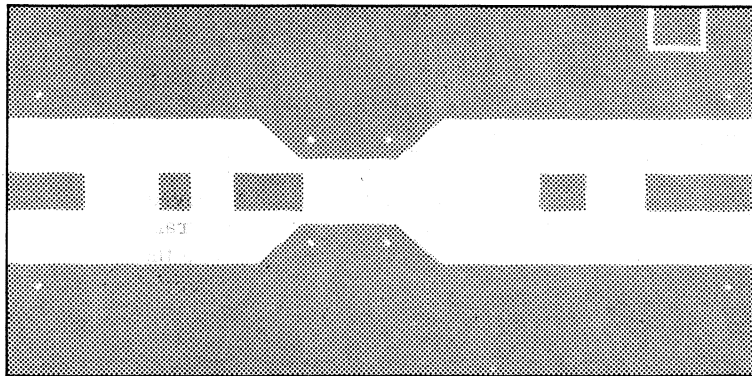
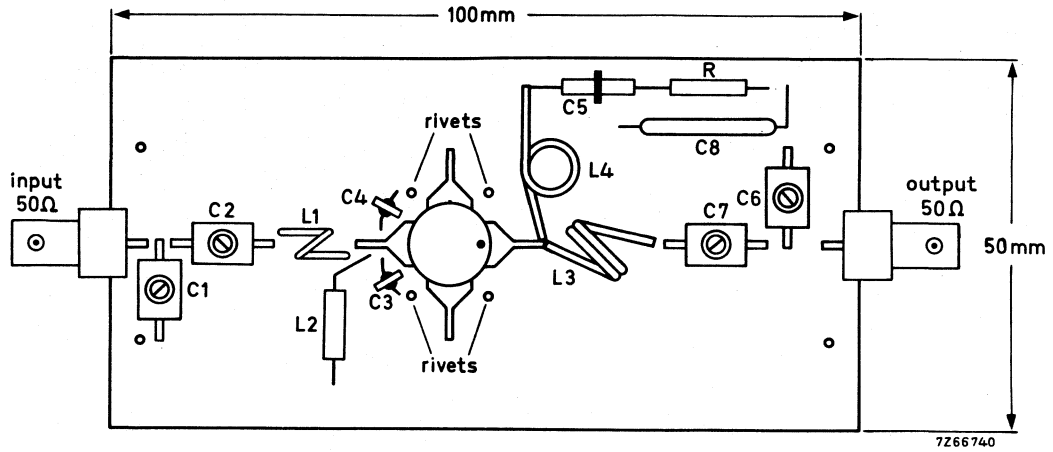
At  $P_L = 2,5$  W and  $V_{CC} = 28$  V, the output power at heatsink temperatures between 25  $^\circ$ C and 90  $^\circ$ C relative to that at 25  $^\circ$ C is diminished by typ. 5 mw/K

The transistor is designed to withstand full load mismatch in the test circuit under the following conditions:  $V_{CC} = 28$  V; f = 470 MHz;  $T_h = 90$   $^\circ$ C.

VSWR = 50 : 1 through all phases;  $P_L = 2,5$  W.

APPLICATION INFORMATION (continued)

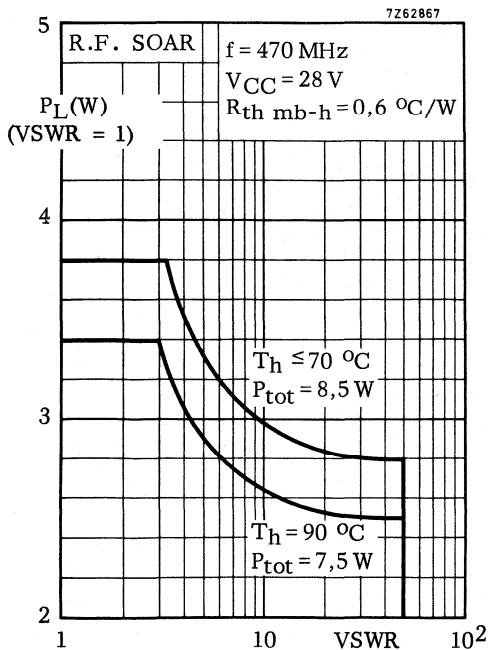
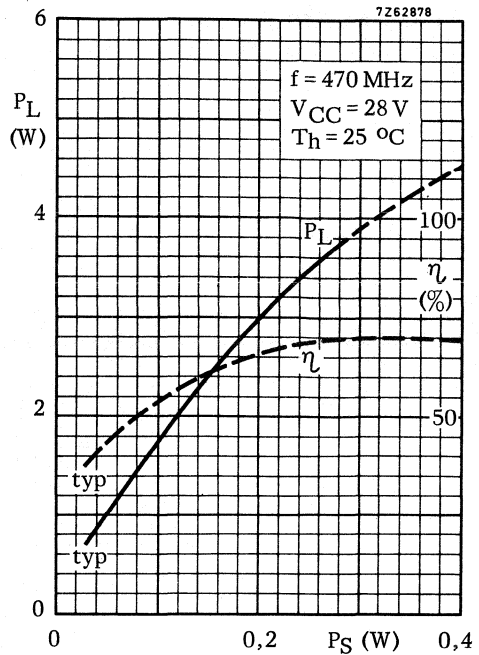
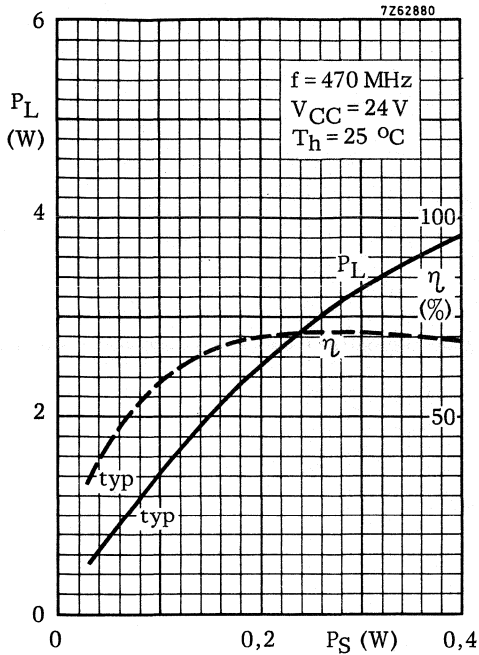
Component layout and printed-circuit board for 470 MHz test circuit.



Shade area copper

Back area completely copper clad

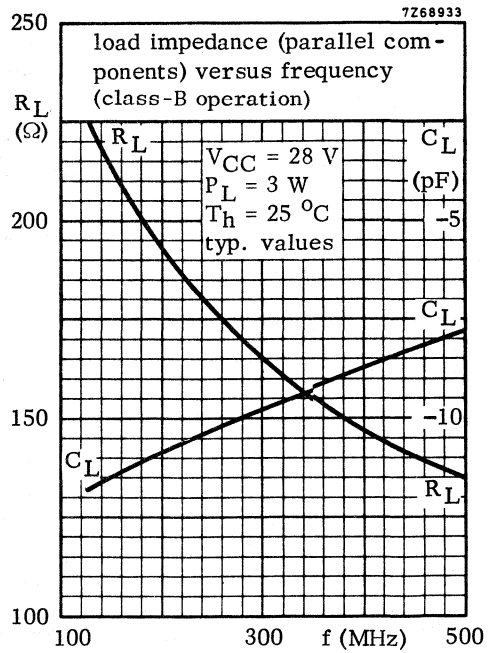
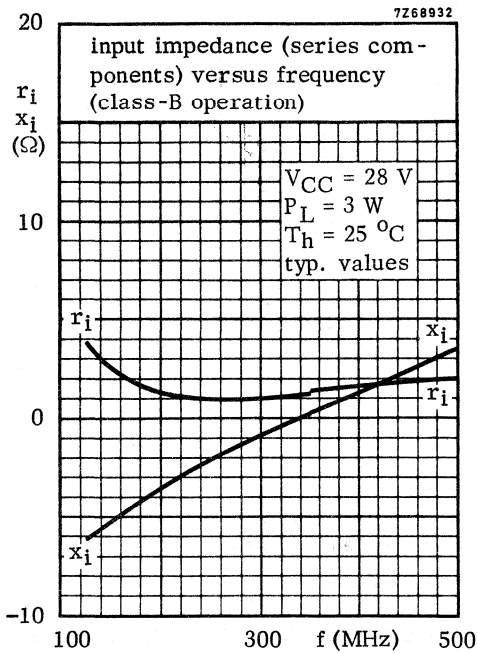
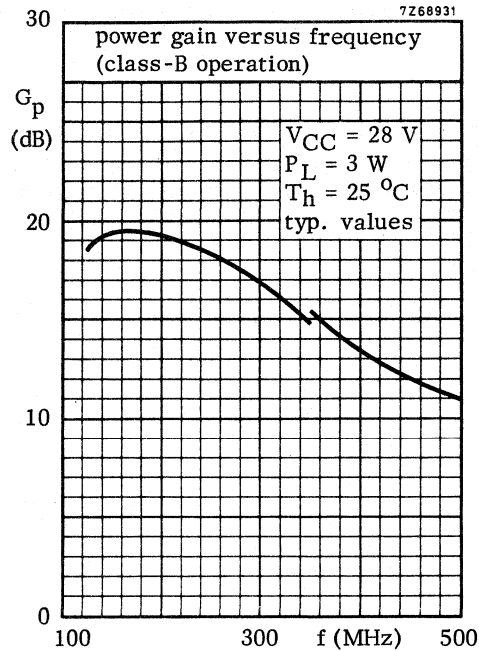
Material of printed-circuit board: 1,5 mm epoxy fibre-glass



Indicated load power as a function of overload

The graph has been derived from an evaluation of the performance of transistors matched up to 3,8 W load power in the test amplifier and subsequently subjected to various mismatch conditions at 28 V with VSWR up to 50 and elevated heatsink temperatures. This indicates a restriction to the load power matched under nominal conditions in the recommended test configuration.

**OPERATING NOTE** Below 350 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for transmitting applications in class-A, B or C with a supply voltage up to 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Gold metallization ensures extremely high reliability.

It has a capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

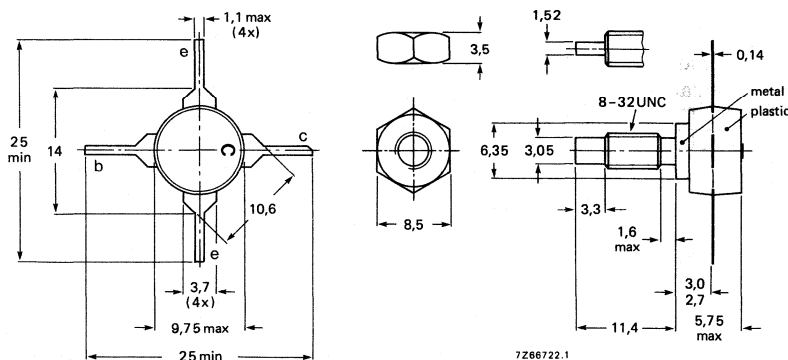
R.F. performance up to  $T_h = 25^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	24	470	typ. 1,0	7,0	typ. 0,42	typ. 8,5	typ. 70	—	—
c.w.	28	470	< 1,0	7,0	< 0,42	> 8,5	> 60	—	—
c.w.	28	470	typ. 1,0	8,0	typ. 0,38	typ. 9,0	typ. 75	$1,8 + j5,3$	$19 - j32$
c.w.	28	1000	typ. 1,5	5,0	typ. 0,40	typ. 5,2	typ. 45	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/3.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	65	V
Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	33	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4,0	V
Collector current (d. c. )	$I_C$	max.	1,0	A
Collector current (peak value) $f \geq 10$ MHz	$I_{CM}$	max.	3,0	A
Total power dissipation up to $T_h = 70$ °C $f \geq 10$ MHz (see also page 3)	$P_{tot}$	max.	12,5	W
Storage temperature	$T_{stg}$		-65 to +150	°C
Operating junction temperature	$T_j$	max.	200	°C

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	9,8	K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,6	K/W



**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage open emitter, $I_C = 10\text{ mA}$	$V_{(BR)CBO}$	>	65	V
Collector-emitter voltage open base, $I_C = 10\text{ mA}$	$V_{(BR)CES}$	>	65	V
Collector-emitter voltage open base, $I_C = 25\text{ mA}$	$V_{(BR)CEO}$	>	33	V
Emitter-base voltage open collector, $I_E = 1,0\text{ mA}$	$V_{(BR)EBO}$	>	4,0	V

## D. C. current gain

$I_C = 100\text{ mA}$ ; $V_{CE} = 5,0\text{ V}$	$h_{FE}$	>	10	
		typ.	35	

## Transition frequency

$I_C = 200\text{ mA}$ ; $V_{CE} = 5,0\text{ V}$	$f_T$	typ.	1,2	GHz
-------------------------------------------------	-------	------	-----	-----

Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0$ ; $V_{CB} = 10\text{ V}$	$C_C$	typ.	14	pF
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Emitter capacitance at  $f = 1\text{ MHz}$ 

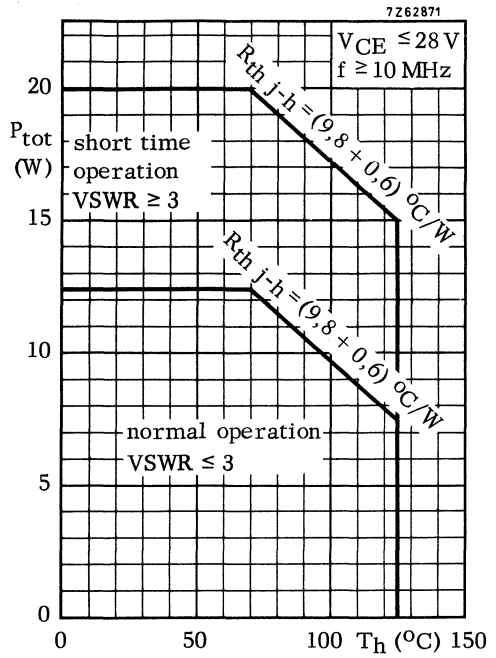
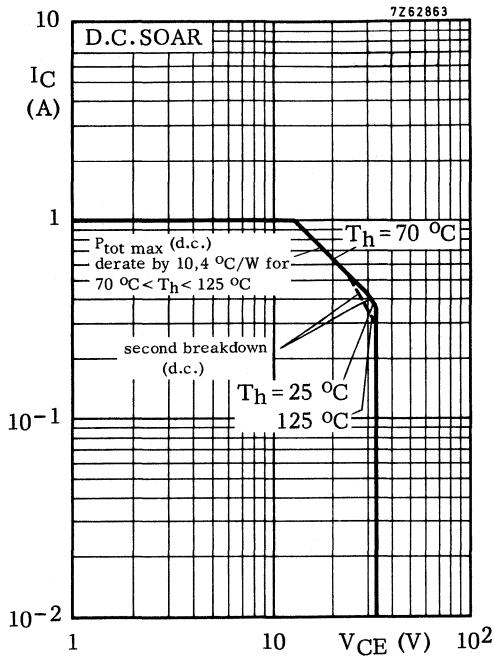
$I_C = I_c = 0$ ; $V_{EB} = 0$	$C_e$	typ.	60	pF
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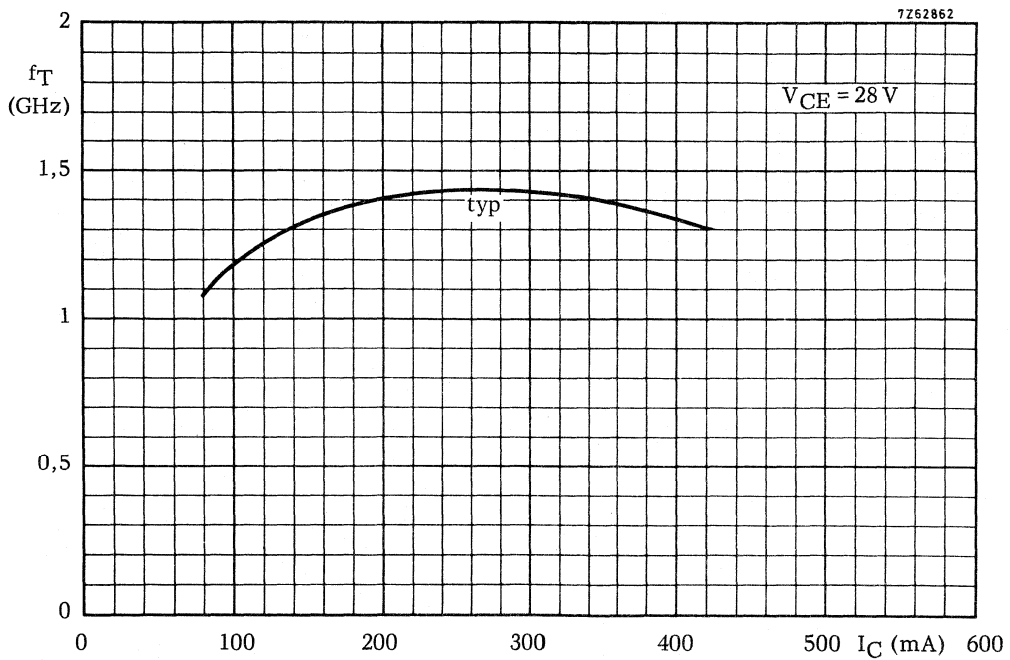
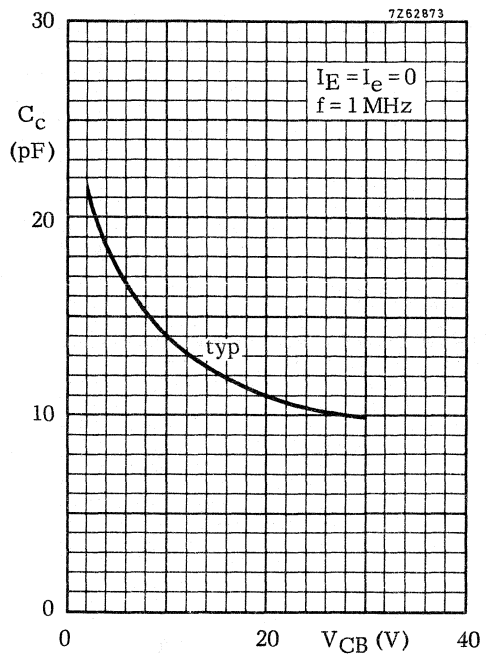
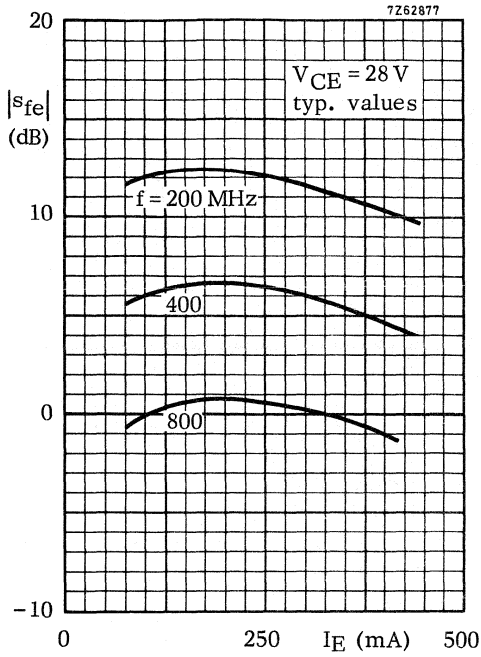
Feedback capacitance at  $f = 1\text{ MHz}$ 

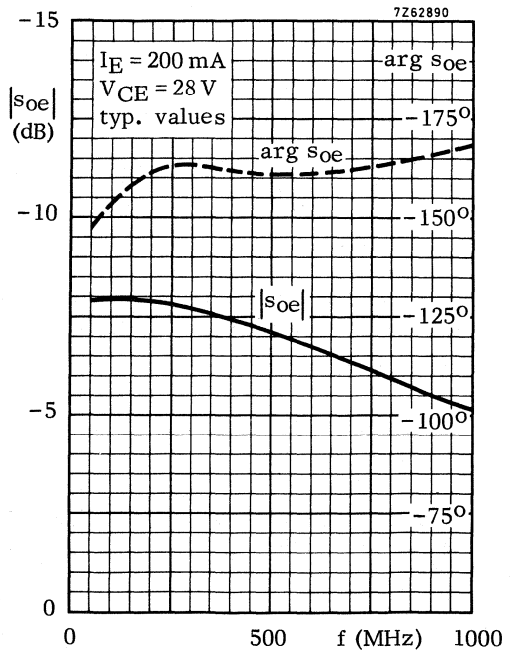
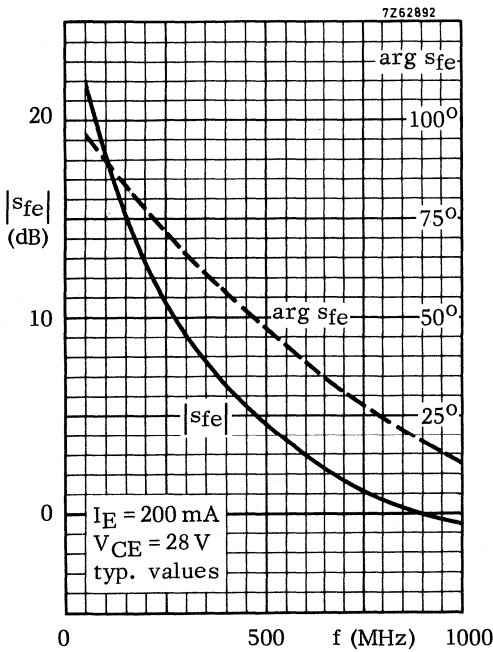
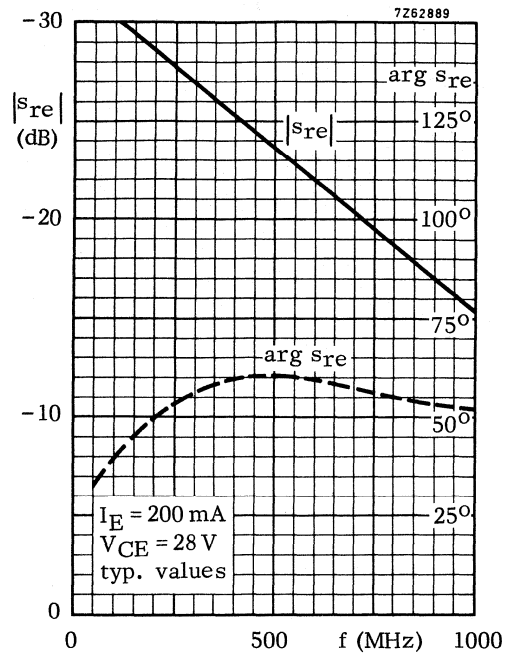
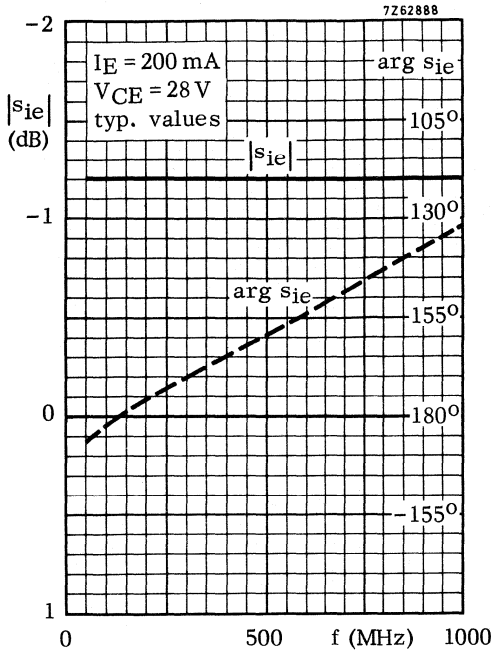
$I_C = 20\text{ mA}$ ; $V_{CE} = 10\text{ V}$	$C_{re}$	typ.	10	pF
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## Collector-stud capacitance

	$C_{cs}$	typ.	2,0	pF
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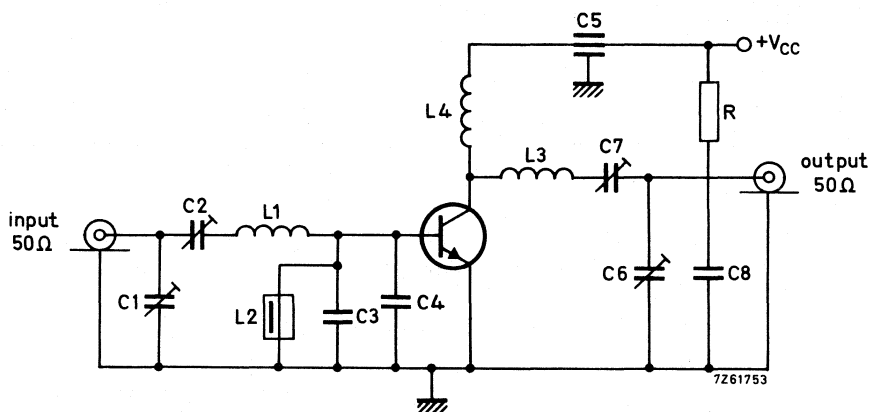
## APPLICATION INFORMATION

R.F. performance in c.w. operation (Unneutralized common-emitter class-B circuit)

$$T_h = 25 \text{ }^\circ\text{C}$$

$V_{CC}$ (V)	f (MHz)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
24	470	typ. 1,0	7,0	typ. 0,42	typ. 8,5	typ. 70	—	—
28	470	< 1,0	7,0	< 0,42	> 8,5	> 60	—	—
28	470	typ. 1,0	8,0	typ. 0,38	typ. 9,0	typ. 75	$1,8 + j5,3$	$19 - j32$
28	1000	typ. 1,5	5,0	typ. 0,40	typ. 5,2	typ. 45	—	—

Test circuit for 470 MHz:



C1 = C2 = 1,8 to 18 pF film dielectric trimmer

C3 = C4 = 18 pF disc ceramic capacitor

C5 = 1 nF feed-through capacitor

C6 = C7 = 1,0 to 9,0 pF film dielectric trimmer

C8 = 0,1  $\mu$ F polyester capacitor

L1 = 1 turn Cu wire (1,2 mm); int. dia. 5 mm; lead length = 2 mm

L2 = 0,47  $\mu$ H choke

L3 = 2 turns closely wound enamelled Cu wire (1,2 mm); int. dia. 6,5 mm; lead length = 4 mm

L4 = 3 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 4,0 mm; lead length = 5 mm

R = 10  $\Omega$  carbon

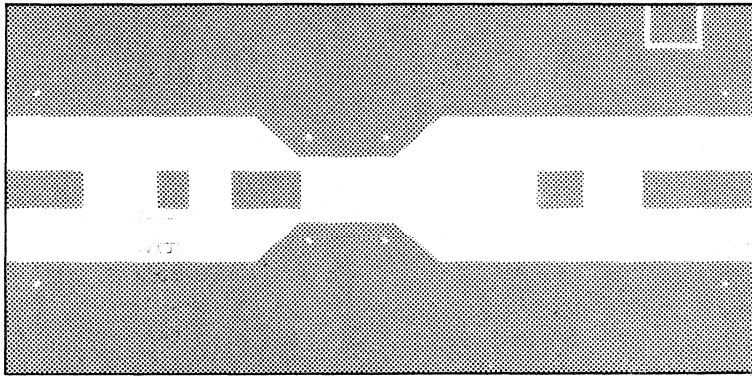
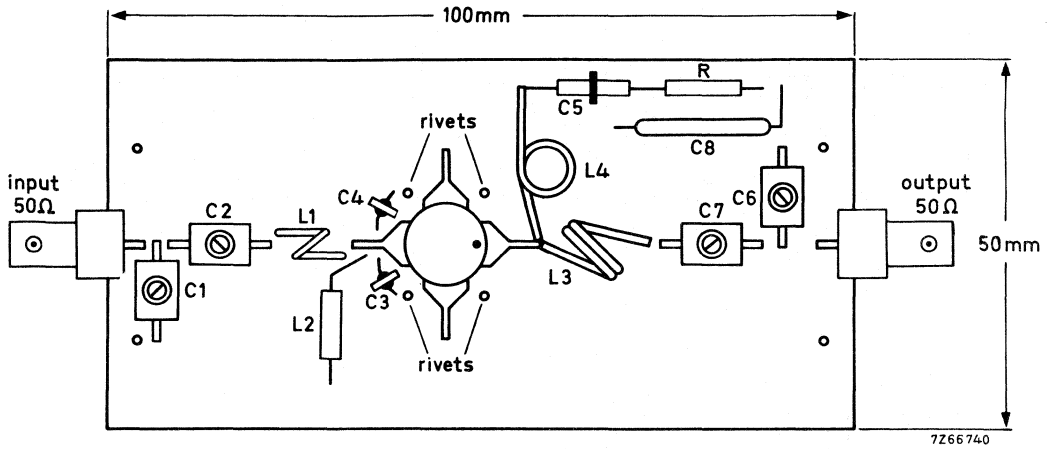
At  $P_L = 7,0$  W and  $V_{CC} = 28$  V, the output power at heatsink temperatures between 25  $^\circ$ C and 90  $^\circ$ C relative to that at 25  $^\circ$ C is diminished by typ. 10 mW/K

The transistor is designed to withstand full load mismatch in the test circuit under the following conditions:  $V_{CC} = 28$  V; f = 470 MHz;  $T_h = 90$   $^\circ$ C.

VSWR = 50 : 1 through all phases;  $P_L = 7,0$  W.

APPLICATION INFORMATION (continued)

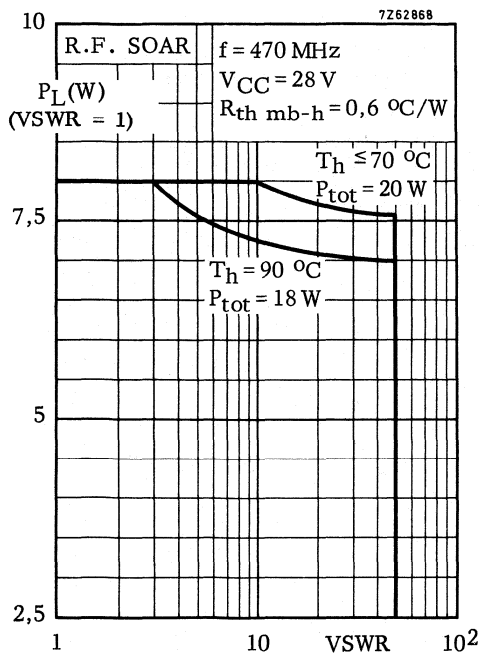
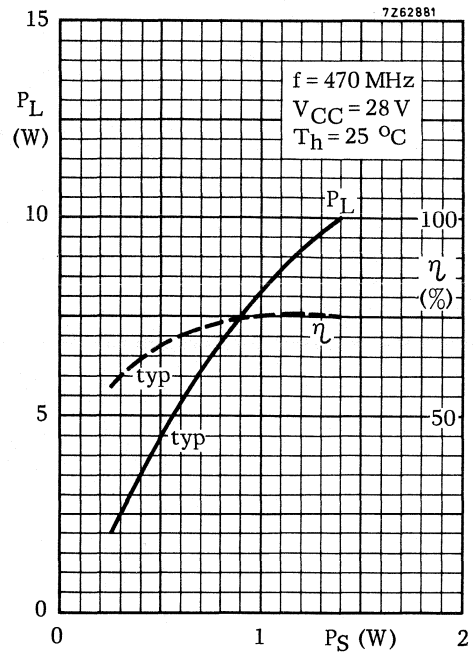
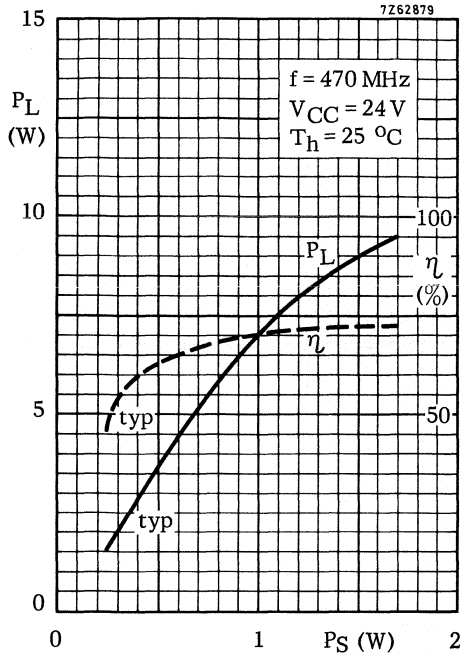
Component layout and printed-circuit board for 470 MHz test circuit.



Shaded area copper

Back area completely copper clad

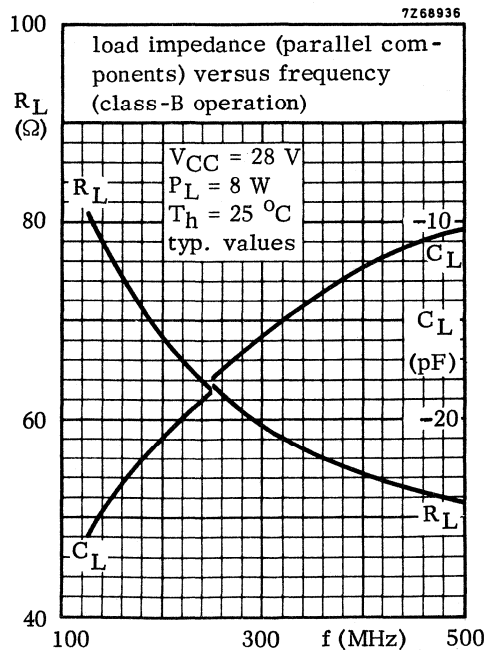
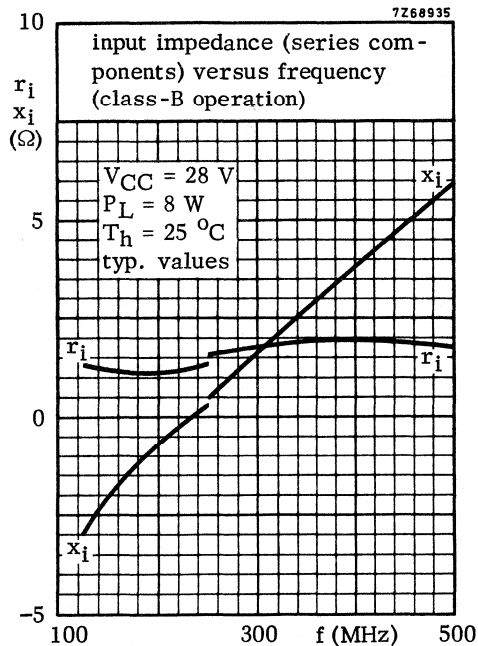
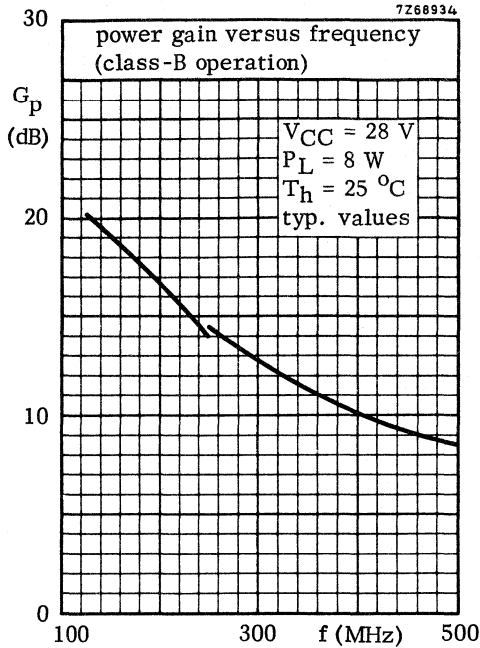
Material of printed-circuit board: 1,5 mm epoxy fibre-glass



Indicated load power as a function of overload

The graph has been derived from an evaluation of the performance of transistors matched up to 8 W load power in the test amplifier and subsequently subjected to various mismatch conditions at 28 V with VSWR up to 50 and elevated heatsink temperatures. This indicates a restriction to the load power matched under nominal conditions in the recommended test configuration.

**OPERATING NOTE** Below 250 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





## U.H.F. POWER TRANSISTORS

N-P-N silicon planar epitaxial transistors suitable for transmitting applications in class-A, B or C in the u.h.f. range for a nominal supply voltage up to 28 V. The transistors are resistance stabilized and tested under severe load mismatch conditions. Diffused emitter-ballasting resistors and gold sandwich metallization ensure excellent reliability properties.

These transistors are housed in capstan envelopes with  $\frac{1}{4}$ " studs, the **BLX94A** has a transfer-moulded cap and the **BLX94C** a ceramic cap.

All leads are isolated from the stud.

## QUICK REFERENCE DATA

R.F. performance at  $T_h = 25^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

type number	mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %
<b>BLX94A</b>	c.w.	28	470	25	> 6	> 55
<b>BLX94C</b>	c.w.	28	470	25	> 6,5	> 55

## MECHANICAL DATA

SOT-48/2 (see Fig. 1a)

SOT-122 (see Fig. 1b)

MECHANICAL DATA

Fig. 1a SOT-48/2 (BLX94A)

Dimensions in mm

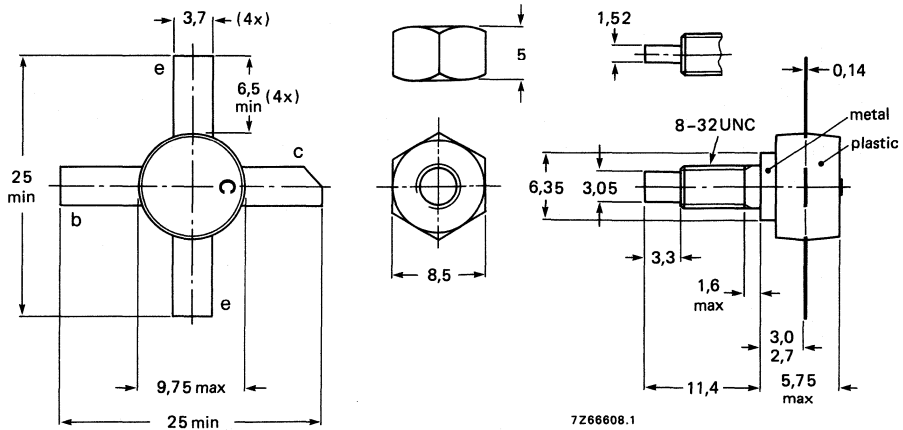
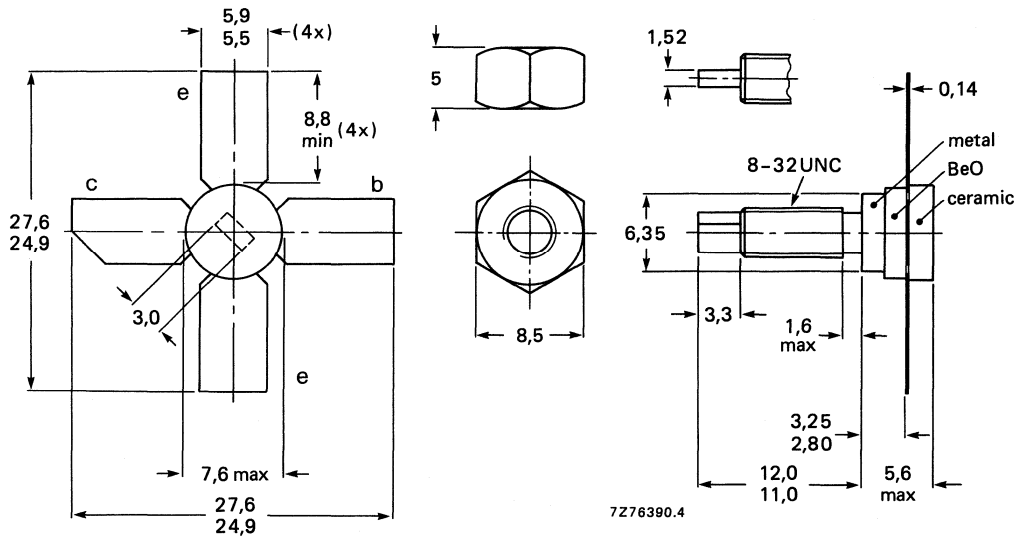


Fig. 1b SOT-122 (BLX94C)



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage  
(peak value);  $V_{BE} = 0$   
open base

$V_{CESM}$  max. 65 V

$V_{CEO}$  max. 30 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current  
d.c. or average

$I_C; I_C(AV)$  max. 2,5 A

(peak value);  $f > 1$  MHz

$I_{CM}$  max. 6,0 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 60 W

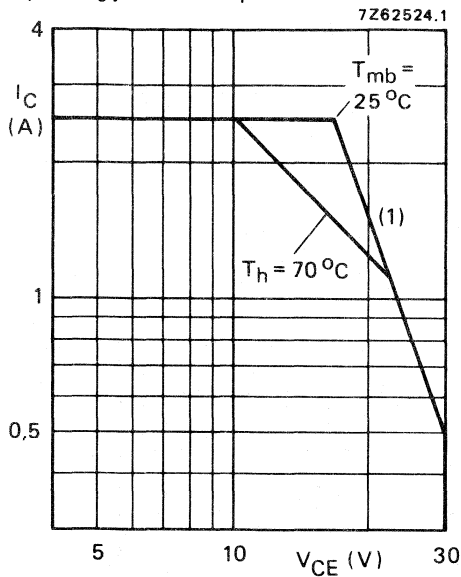
Storage temperature

BLX94A  $T_{stg}$  -65 to +200 °C

BLX94C  $T_{stg}$  -65 to +150 °C

Operating junction temperature

$T_j$  max. 200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

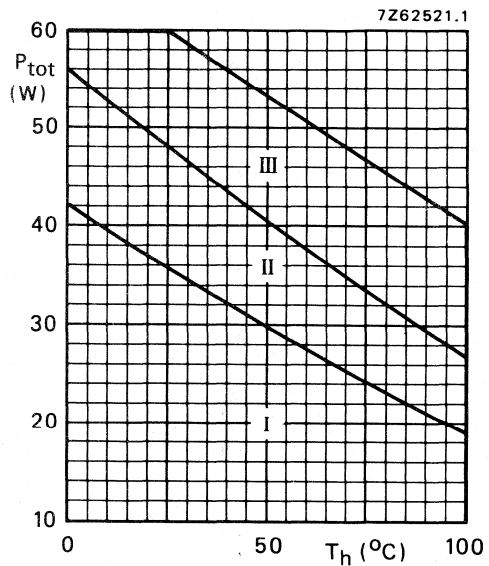


Fig. 3 Power derating curve vs. temperature.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 20 W;  $T_{mb} = 82$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th j-mb(dc)}$  = 4,0 K/W

From junction to mounting base (r.f. dissipation)

$R_{th j-mb(rf)}$  = 2,7 K/W

From mounting base to heatsink

$R_{th mb-h}$  = 0,6 K/W

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 25\text{ mA}$

$V_{(BR)CES} > 65\text{ V}$

Collector-emitter breakdown voltage

open base;  $I_C = 100\text{ mA}$

$V_{(BR)CEO} > 30\text{ V}$

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Collector cut-off current

$V_{BE} = 0; V_{CE} = 30\text{ V}$

$I_{CES} < 10\text{ mA}$

Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$

open base

$R_{BE} = 10\ \Omega$

$E_{SBO} > 3\text{ mJ}$

$E_{SBR} > 3\text{ mJ}$

D.C. current gain \*

$I_C = 1,5\text{ A}; V_{CE} = 5\text{ V}$

$h_{FE} > 15$   
typ. 50

Collector-emitter saturation voltage \*

$I_C = 4,0\text{ A}; I_B = 0,8\text{ A}$

$V_{CEsat}$  typ. 1,5 V

Transition frequency at  $f = 500\text{ MHz}$  \*

$-I_E = 1,5\text{ A}; V_{CB} = 28\text{ V}$

$-I_E = 4,0\text{ A}; V_{CB} = 28\text{ V}$

$f_T$  typ. 1,1 GHz

$f_T$  typ. 0,75 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 28\text{ V}$

$C_C$  typ. 33 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 20\text{ mA}; V_{CE} = 28\text{ V}$

$C_{re}$  typ. 18 pF

Collector-stud capacitance

$C_{CS}$  typ. 1,2 pF

\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}; \delta \leq 0,02$ .

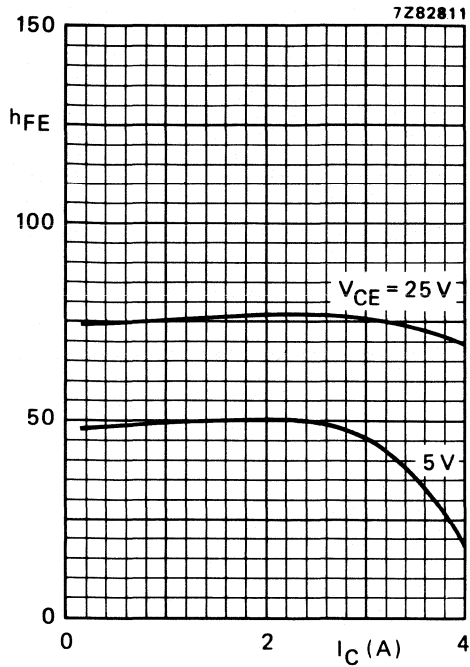


Fig. 4 Typical values;  $T_j = 25^\circ C$ .

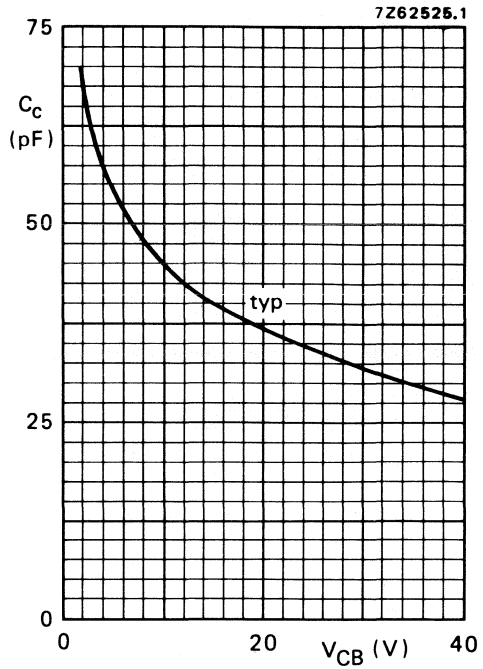


Fig. 5  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25^\circ C$ .

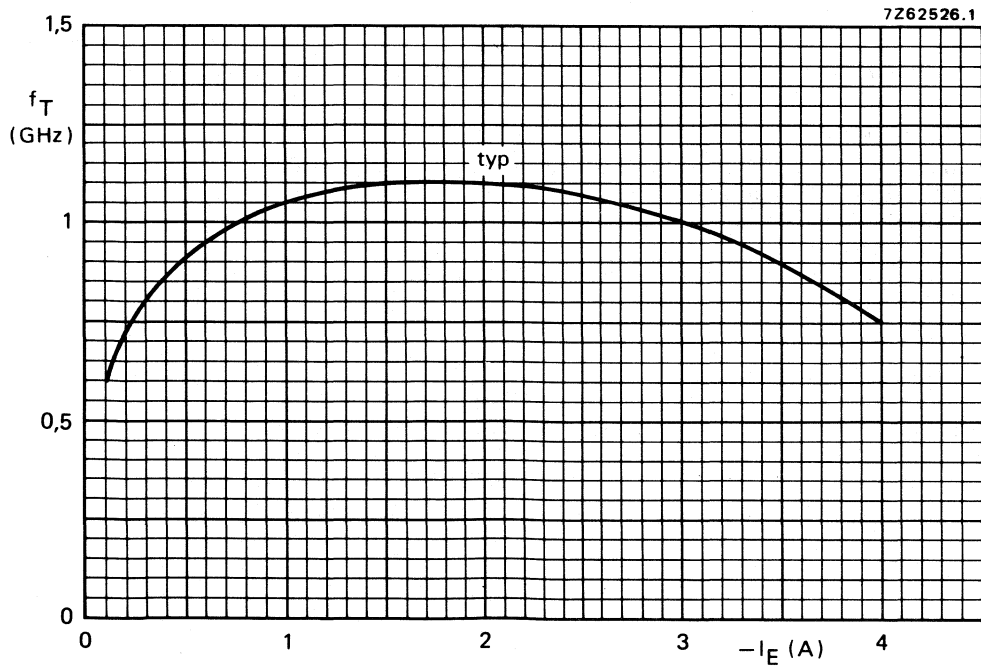


Fig. 6  $V_{CB} = 28V$ ;  $T_j = 25^\circ C$ .

APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

$f = 470 \text{ MHz}$ ;  $T_h = 25 \text{ }^\circ\text{C}$

type number	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Z}_L$ ( $\Omega$ )
BLX94A	28	25	< 6,25 >	6	< 1,62 >	55	—	—
	28	25	typ. 5,6	typ. 6,5	typ. 1,49	typ. 60	$0,9 + j4,1$	$6,6 + j6,4$
BLX94C	28	25	< 5,6 >	6,5	< 1,62 >	55	—	—
	28	25	typ. 4,7	typ. 7,25	typ. 1,54	typ. 58	$0,7 + j2,6$	$5,8 + j6,3$

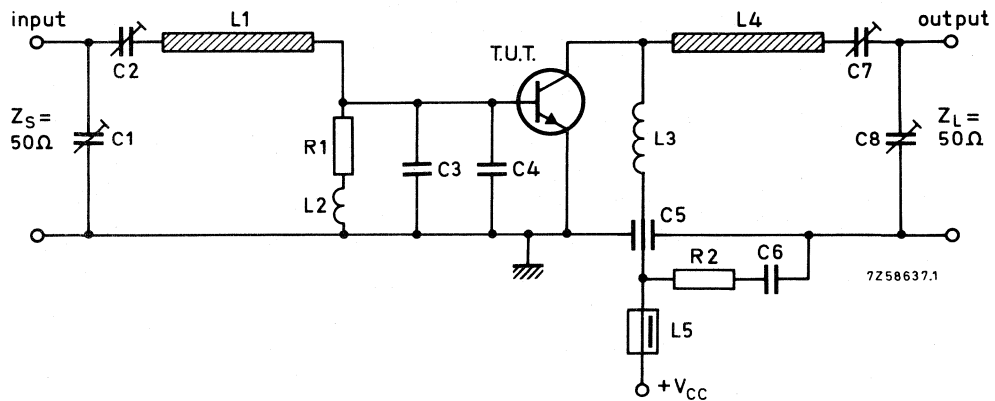


Fig. 7 470 MHz test circuit; c.w. class-B. For component layout and p.c.b. see Fig. 8.

List of components:

C1 = C2 = C8 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C3 = C4 = 15 pF chip capacitor

C5 = 100 pF feed-through capacitor

C6 = 33 nF polyester capacitor

C7 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)

R1 = 1  $\Omega$  carbon resistor

R2 = 10  $\Omega$  carbon resistor

L1 = stripline (41,1 mm x 5,0 mm)

L2 = 13 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 4,0 mm

L3 = 2 turns Cu wire (1 mm); winding pitch 1,5 mm; int. dia. 4 mm; leads 2 x 5 mm

L4 = stripline (52,7 mm x 5,0 mm)

L5 = Ferroxcube choke coil. Z (at  $f = 50 \text{ MHz}$ ) =  $750 \Omega \pm 20\%$  (cat. no. 4312 020 36640)

L1 and L4 are striplines on a double Cu-clad print plate with PTFE fibre-glass dielectric.

( $\epsilon_r = 2,74$ ); thickness 1,45 mm.

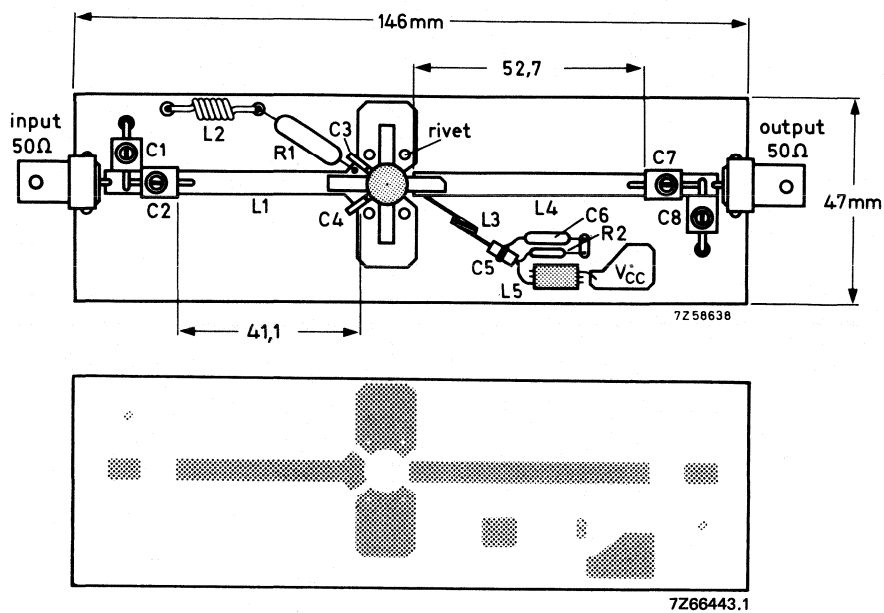


Fig. 8 Component layout and printed-circuit board for 470 MHz test circuit.

The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.

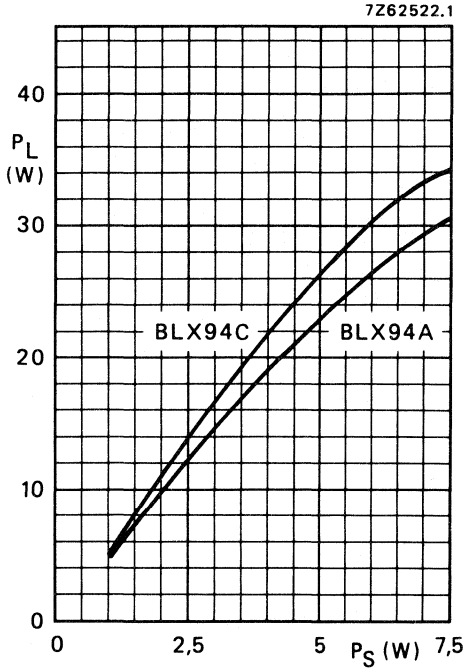


Fig. 9  $V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 25$  °C; typical values.

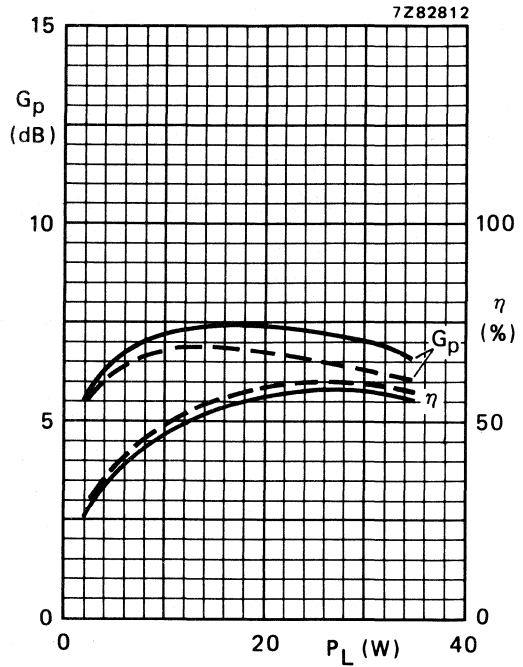


Fig. 10  $V_{CE} = 28$  V;  $f = 470$  MHz;  $T_h = 25$  °C; typ. values; --- BLX94A; — BLX94C.

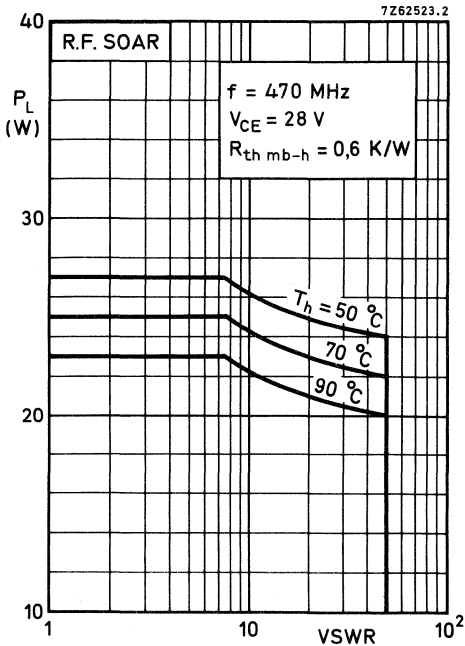


Fig. 11 For high voltage operation, a stabilized power supply is generally used. The graph shows the permissible output power under nominal conditions as a function of the VSWR, with heatsink temperature as parameter.



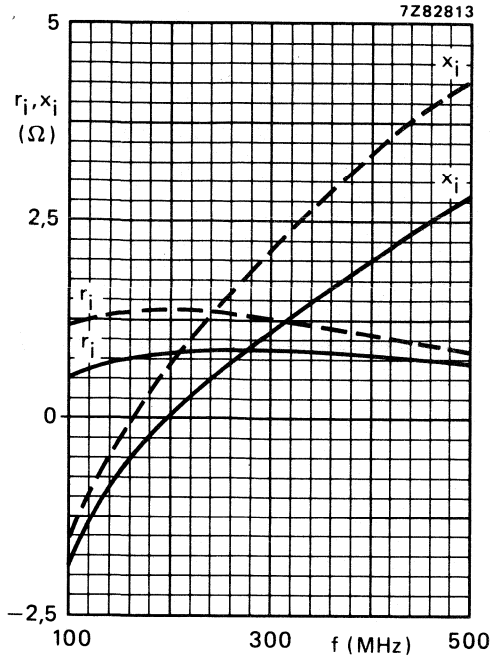


Fig. 12 Input impedance (series components).

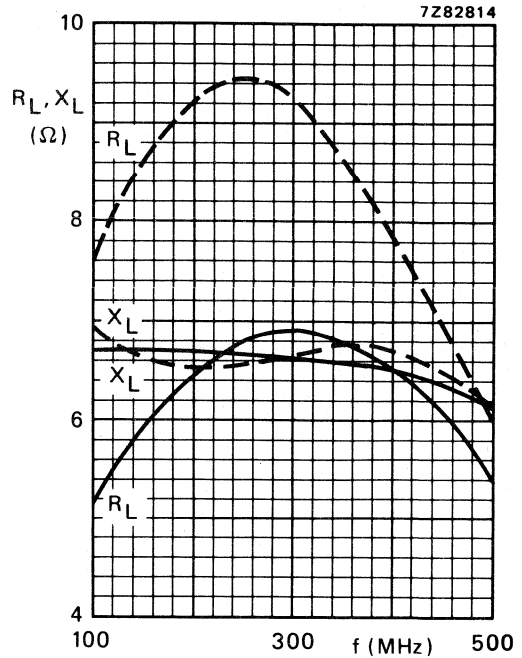


Fig. 13 Load impedance (series components).

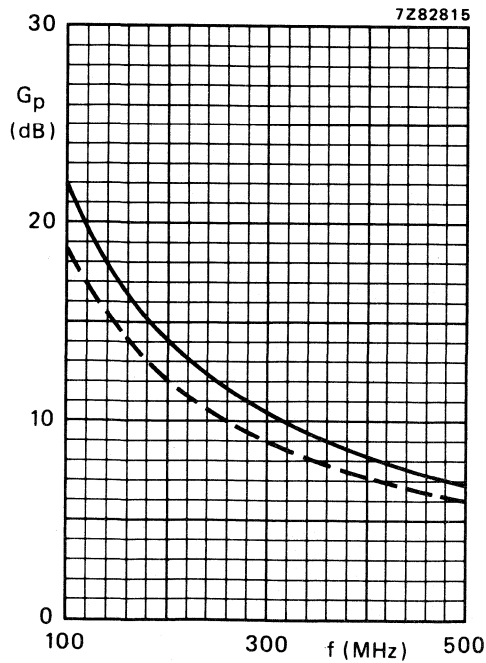


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 28$  V;  $P_L = 25$  W;

$T_h = 25$  °C; class-B operation;

--- BLX94A; — BLX94C.



## U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for transmitting applications in class-A, B or C in the u.h.f. frequency range for supply voltages up to 28 V. The transistor is resistance stabilized and is tested under severe load mismatch conditions. Due to a gold metallization excellent reliability properties have been obtained. The transistor is housed in a capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

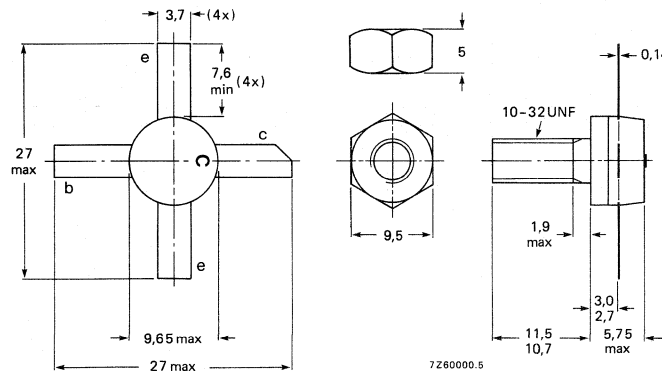
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_p$ dB	$\eta$ %
c.w.	28	470	< 14,2	40	< 2,4	< 4,5	> 60
c.w.	28	175	typ. 3,2	40	typ. 1,9	typ. 11	typ. 75

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-56.



Torque on nut: min. 1,5 Nm  
(15 kg cm)  
max. 1,7 Nm  
(17 kg cm)

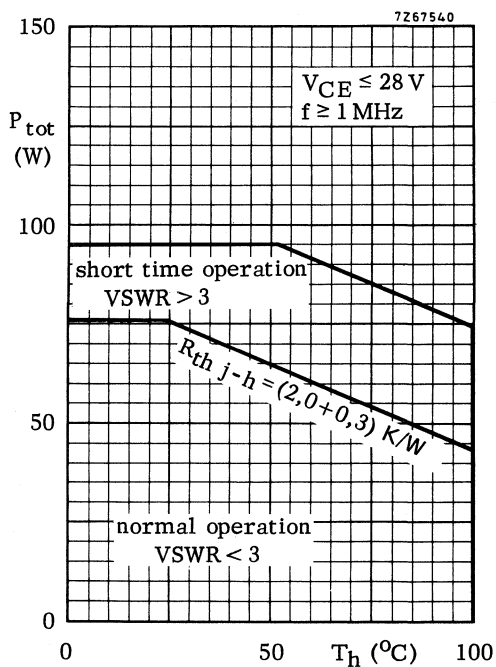
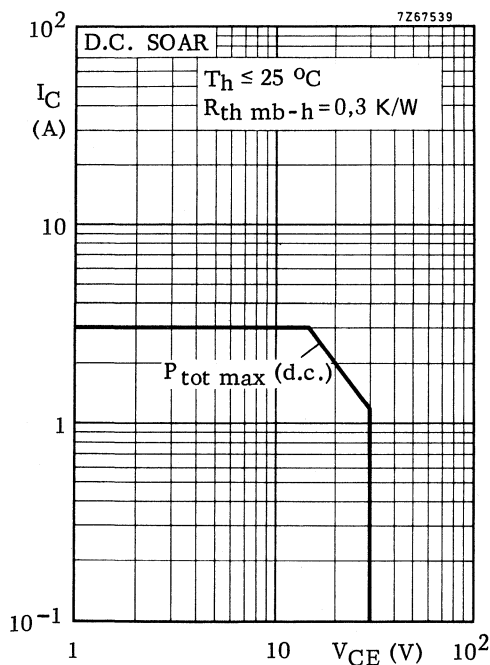
Diameter of clearance hole in heatsink: max. 4,9 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer  
or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	65 V
Collector-emitter voltage ( $R_{BE} = 10\Omega$ ) peak value	$V_{CERM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	30 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	3,0 A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	10,0 A



Storage temperature	$T_{stg}$	-65 to +200 °C
Junction temperature	$T_j$	max. 200 °C

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th j-mb}$	=	2,0 K/W
From mounting base to heatsink	$R_{th mb-h}$	=	0,3 K/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Breakdown voltages

Collector-base voltage

open emitter,  $I_C = 50\text{ mA}$  $V_{(BR)CBO} > 65\text{ V}$ 

Collector-emitter voltage

 $R_{BE} = 10\ \Omega$ ,  $I_C = 50\text{ mA}$  $V_{(BR)CER} > 65\text{ V}$ 

Collector-emitter voltage

open base,  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 30\text{ V}$ 

Emitter-base voltage

open collector,  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Transient energy

 $L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$ open base  
 $-V_{BE} = 1,5\text{ V}$ ;  $R_{BE} = 33\ \Omega$  $E > 4,5\text{ mS}$   
 $E > 4,5\text{ mS}$ 

D.C. current gain

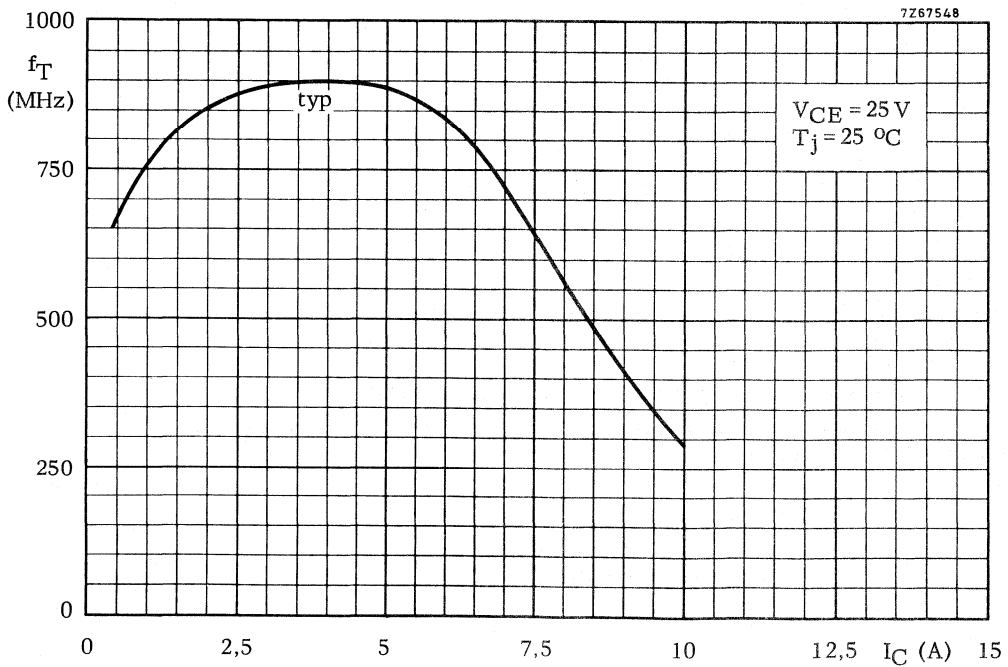
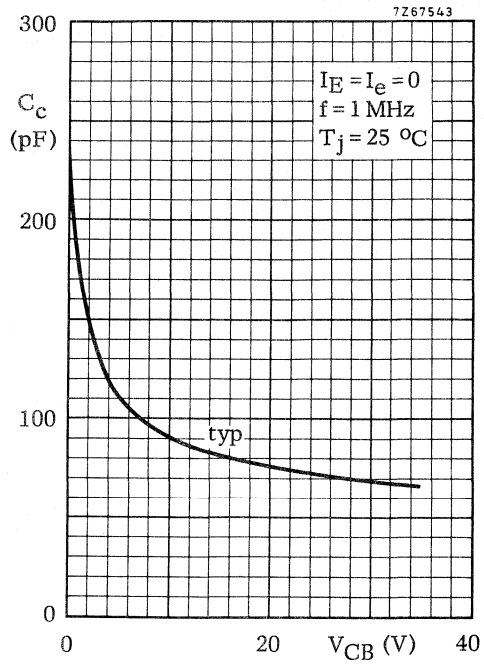
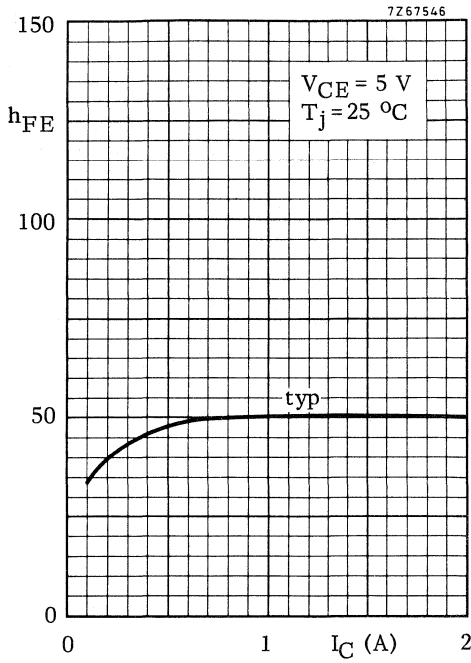
 $I_C = 1,0\text{ A}$ ;  $V_{CE} = 5\text{ V}$  $h_{FE} \quad 25\text{ to }100$ 

Transition frequency

 $I_C = 4\text{ A}$ ;  $V_{CE} = 25\text{ V}$  $f_T \quad \text{typ. } 900\text{ MHz}$ Collector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0$ ;  $V_{CB} = 30\text{ V}$  $C_c \quad \text{typ. } 68\text{ pF}$   
 $< 80\text{ pF}$ Feedback capacitance at  $f = 1\text{ MHz}$  $I_C = 200\text{ mA}$ ;  $V_{CE} = 30\text{ V}$  $C_{re} \quad \text{typ. } 39\text{ pF}$ 

Collector-stud capacitance

 $C_{cs} \quad \text{typ. } 2\text{ pF}$



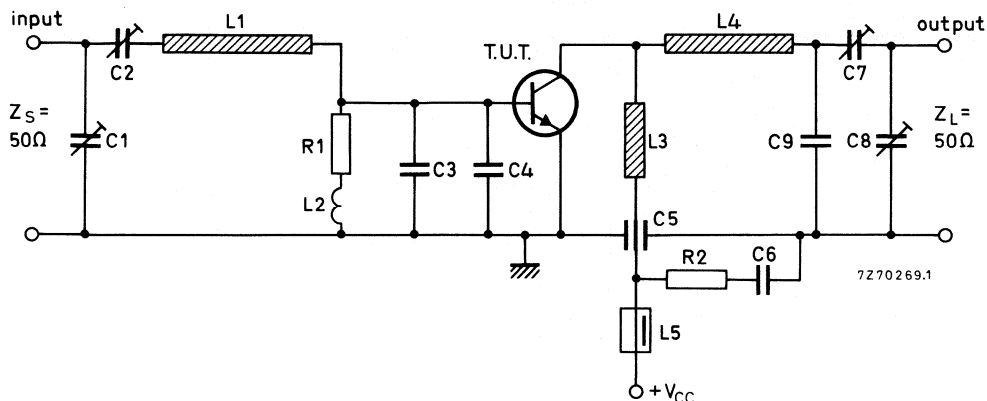
## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $V_{CE} = 28 \text{ V}$ ;  $T_h$  up to  $25 \text{ }^\circ\text{C}$ 

f (MHz)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)
470	< 14,2	40	< 2,4	> 4,5	> 60
175	typ. 3,2	40	typ. 1,9	typ. 11	typ. 75

Test circuit: 470 MHz; c.w. class-B.



List of components:

C1 = C7 = C8 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)

C2 = 1,8 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)

C3 = C4 = 18 pF chip capacitor

C5 = 100 pF feed-through capacitor

C6 = 33 nF polyester capacitor

C9 = 2 x 3,3 pF miniature ceramic plate capacitors (in parallel)

R1 = 1  $\Omega$  carbon resistor (0,25 W)R2 = 10  $\Omega$  carbon resistor (0,25 W)

L1 = stripline (21,4 mm x 5,3 mm)

L2 = 13 turns closely wound enamelled Cu wire (0,5 mm); internal diameter 4,0 mm

L3 = stripline (43,8 mm x 3,0 mm)

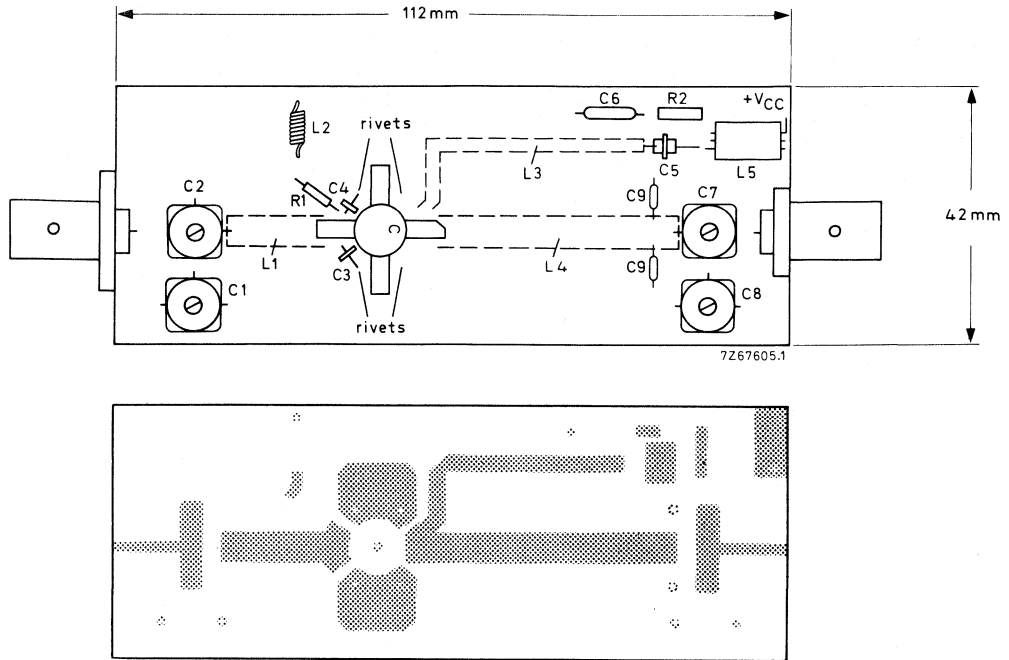
L4 = stripline (45,5 mm x 5,3 mm)

L5 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L1; L3; L4 are striplines on a double-clad print plate with PTFE fibre-glass dielectric. ( $\epsilon_r = 2,74$ ); thickness 1/32".At  $P_L = 40 \text{ W}$  and  $V_{CE} = 28 \text{ V}$ , the output power at heatsink temperatures between  $25 \text{ }^\circ\text{C}$  and  $70 \text{ }^\circ\text{C}$  relative to that at  $25 \text{ }^\circ\text{C}$  is diminished by typ. 50 mW/K.The transistor is designed to withstand full load mismatch in the test circuit under the following conditions:  $V_{CE} = 28 \text{ V}$ ;  $f = 470 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ .VSWR = 50 through all phases;  $P_L = 36 \text{ W}$ .

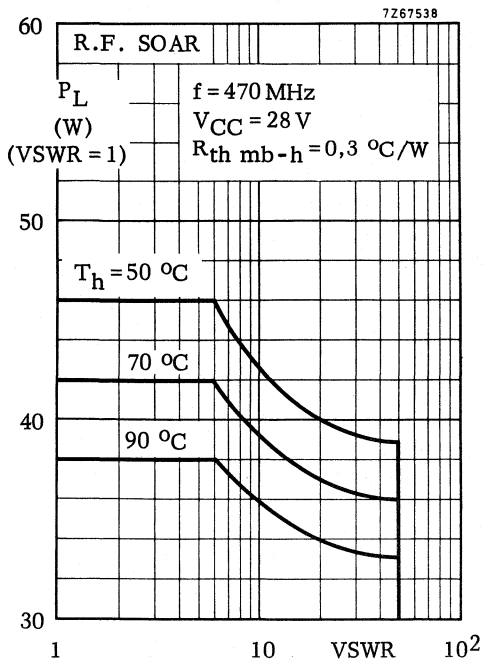
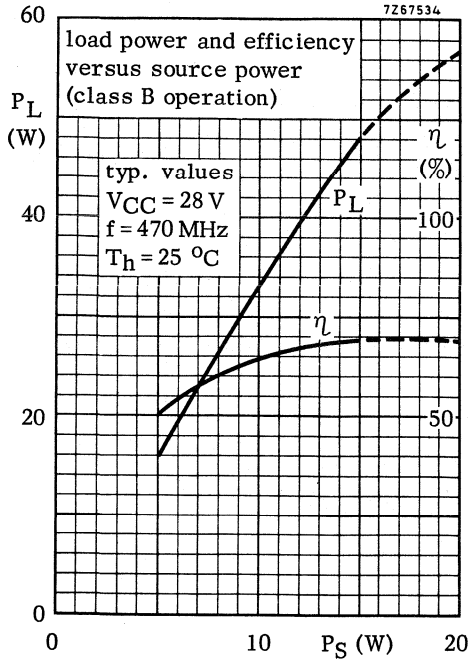
APPLICATION INFORMATION (continued)

Component layout and printed-circuit board for 470 MHz test circuit.



The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.





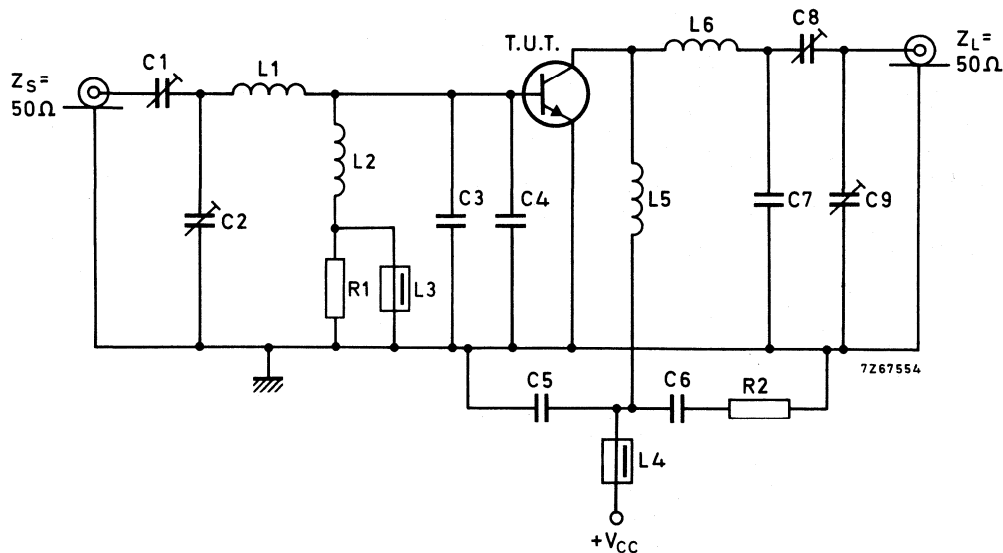
Indicated load power as a function of overload.

The graph has been derived from an evaluation of the performance of transistors matched up to 46W load power in the test amplifier and subsequently subjected to various mismatch conditions at 28V with VSWR up to 50 and elevated heatsink temperatures.

This indicates a restriction to the load power matched under nominal conditions in the recommended test configuration.

## APPLICATION INFORMATION (continued)

Test circuit for 175 MHz:

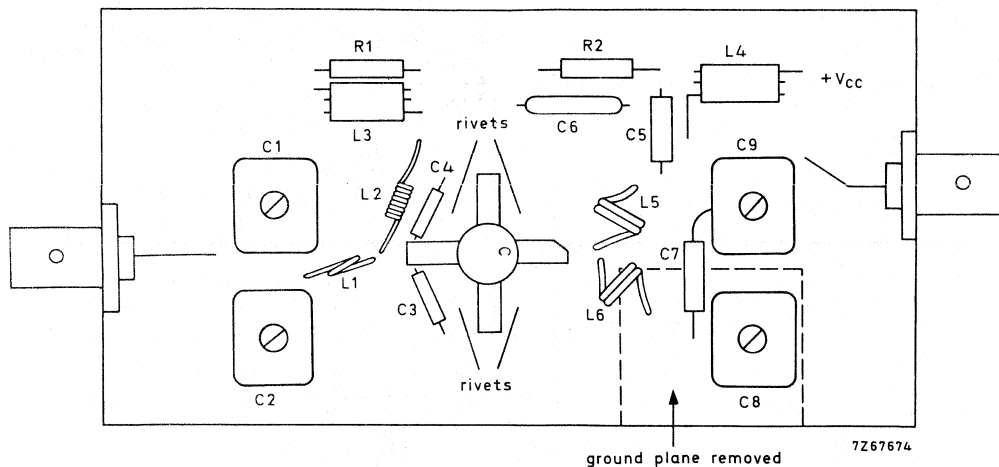


List of components:

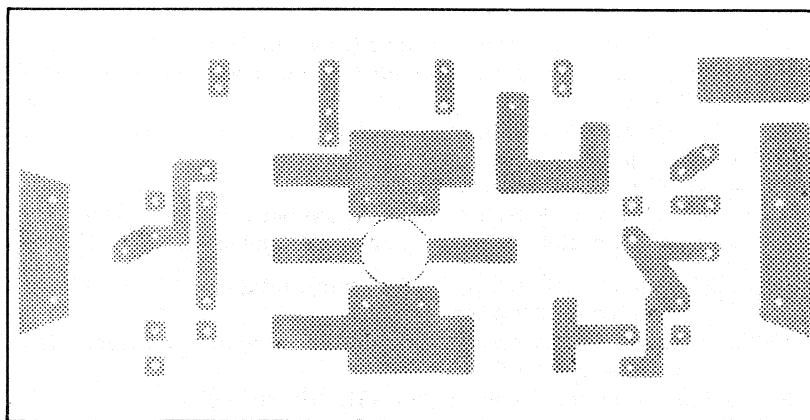
- C1 = 2,5 to 20 pF film dielectric trimmer (code number 2222 809 07004)  
 C2 = 4 to 40 pF film dielectric trimmer (code number 2222 809 07008)  
 C3 = C4 = 47 pF ceramic capacitor  
 C5 = 100 pF ceramic capacitor  
 C6 = 100 nF polyester capacitor  
 C7 = 6,8 pF ceramic capacitor  
 C8 = 4 to 60 pF film dielectric trimmer (code number 2222 809 07011)  
 C9 = 4 to 100 pF film dielectric trimmer (code number 2222 809 07015)
- L1 = 0,5 turn enamelled Cu wire (1,5 mm); int. diam. 6 mm;  
 lead length 2 x 6 mm  
 L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. diam. 3 mm;  
 lead length 2 x 5 mm  
 L3 = L4 = ferroxcube choke coil (code number 4312 020 36640)  
 L5 = 53 nH; 2 turns enamelled Cu wire (1,5 mm); int. diam. 10 mm;  
 coil length 5,2 mm; lead length 2 x 5 mm  
 L6 = 46 nH; 2 turns enamelled Cu wire (1,5 mm); int. diam. 9 mm;  
 coil length 5,4 mm; lead length 2 x 5 mm
- R1 = R2 = 10  $\Omega$  carbon resistor (0,25W)

**APPLICATION INFORMATION** (continued)

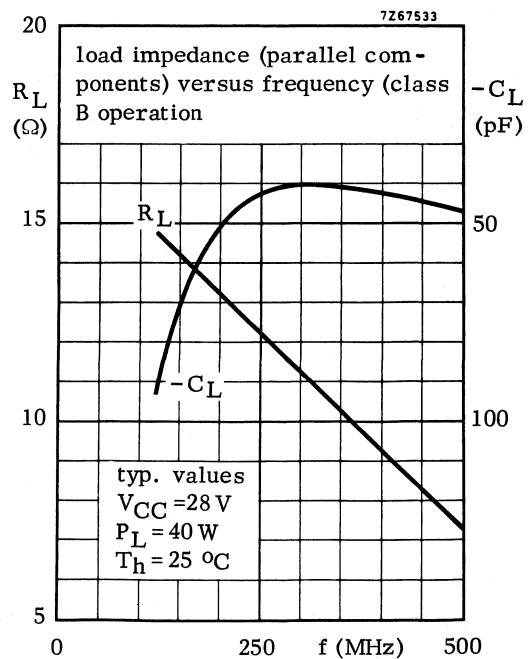
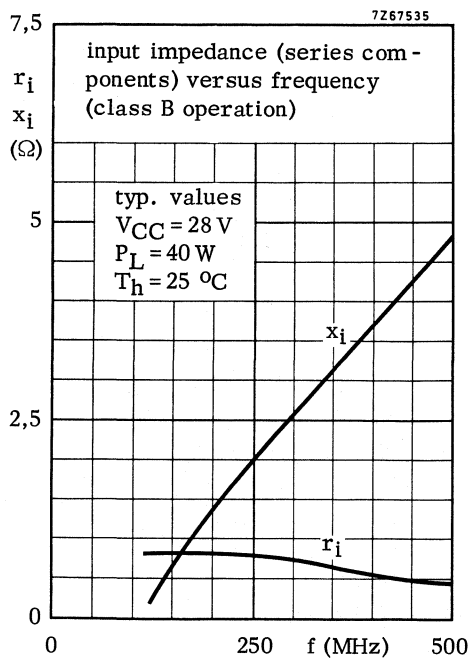
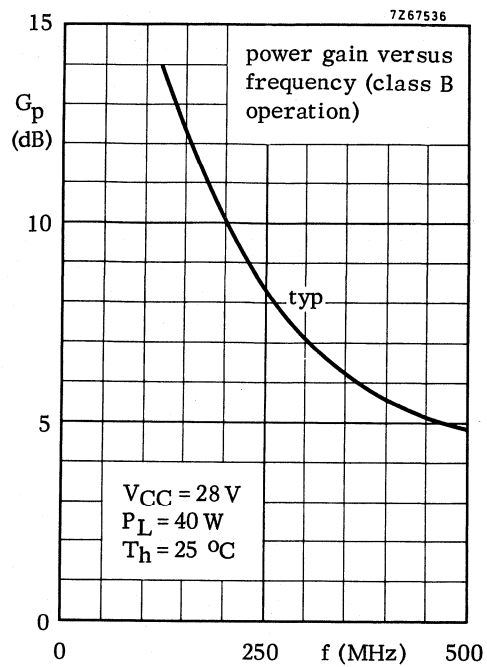
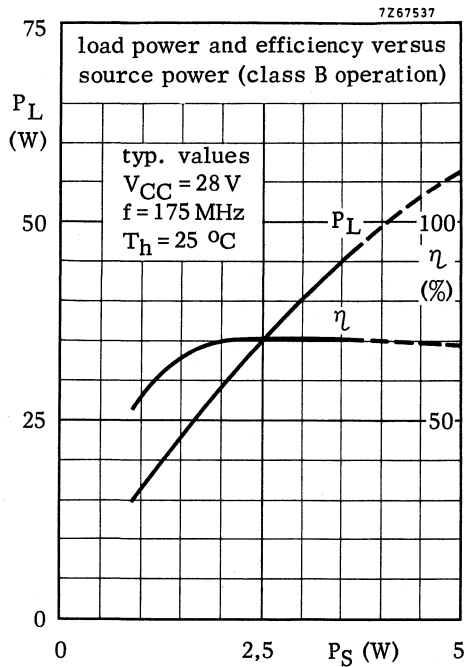
Component lay-out and printed circuit board for 175 MHz test circuit.



Dimensions of printed circuit board 123 mm x 55 mm.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.



## U.H.F. LINEAR POWER TRANSISTOR

N-P-N multi-emitter silicon planar epitaxial transistor primarily for use in linear u.h.f. amplifiers for television transposers and transmitters.

Features:

- guaranteed low intermodulation figures;
- gold metallization ensures excellent reliability.

The transistor has a ¼" capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

R.F. performance in linear amplifier

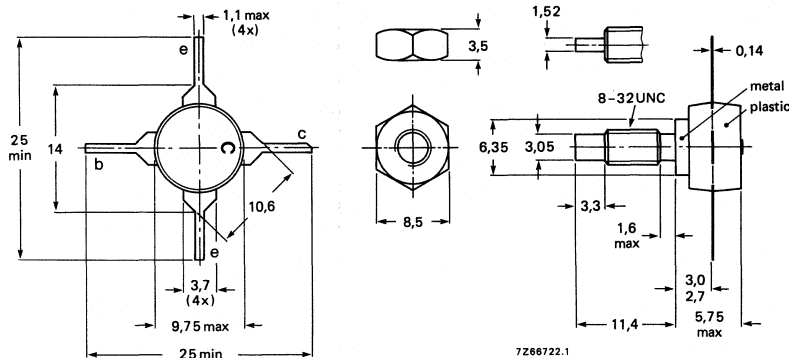
mode of operation	f <sub>vision</sub> MHz	V <sub>CE</sub> V	I <sub>C</sub> mA	T <sub>h</sub> °C	d <sub>im</sub> * dB	P <sub>o sync</sub> * W	G <sub>p</sub> dB
class-A	860	25	250	25	-60	> 0,5	> 6
class-A	860	25	250	25	-60	typ. 0,6	typ. 7

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/3.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

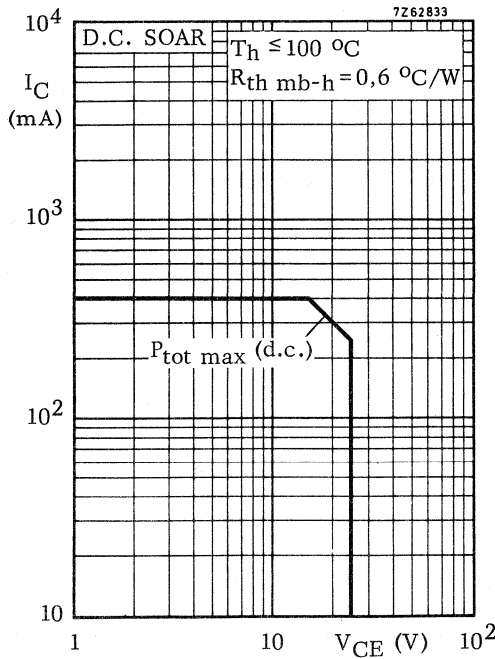
Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter; peak value)	$V_{CBOM}$	max.	40	V
Collector-emitter voltage ( $R_{BE} = 10 \Omega$ ; peak value)	$V_{CERM}$	max.	40	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	27	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3,5	V
Collector current (d.c.)	$I_C$	max.	0,4	A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	1	A
Total power dissipation up to $T_h = 100 \text{ }^\circ\text{C}$	$P_{tot}$	max.	6,25	W



Storage temperature	$T_{stg}$	-65 to +200	$^\circ\text{C}$
Junction temperature	$T_j$	max. 200	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	15	K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,6	K/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20\text{ V}$

$I_{CBO} < 100\text{ }\mu\text{A}$

Breakdown voltages

Collector-base voltage

open emitter;  $I_C = 1\text{ mA}$

$V_{(BR)CBO} > 40\text{ V}$

Collector-emitter voltage

$R_{BE} = 10\text{ }\Omega; I_C = 5\text{ mA}$

$V_{(BR)CER} > 40\text{ V}$

open base;  $I_C = 5\text{ mA}$

$V_{(BR)CEO} > 27\text{ V}$

Emitter-base voltage

open collector;  $I_E = 1\text{ mA}$

$V_{(BR)EBO} > 3,5\text{ V}$

Saturation voltage

$I_C = 200\text{ mA}; I_B = 20\text{ mA}$

$V_{CEsat} < 0,75\text{ V}$

D.C. current gain

$I_C = 200\text{ mA}; V_{CE} = 20\text{ V}$

$h_{FE} > 30$

$I_C = 400\text{ mA}; V_{CE} = 20\text{ V}$

$h_{FE} > 20$

Transition frequency

$I_C = 200\text{ mA}; V_{CE} = 20\text{ V}$

$f_T > 1,2\text{ GHz}$

$I_C = 350\text{ mA}; V_{CE} = 20\text{ V}$

$f_T > 1,0\text{ GHz}$

Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0; V_{CB} = 20\text{ V}$

$C_c < 10\text{ pF}$

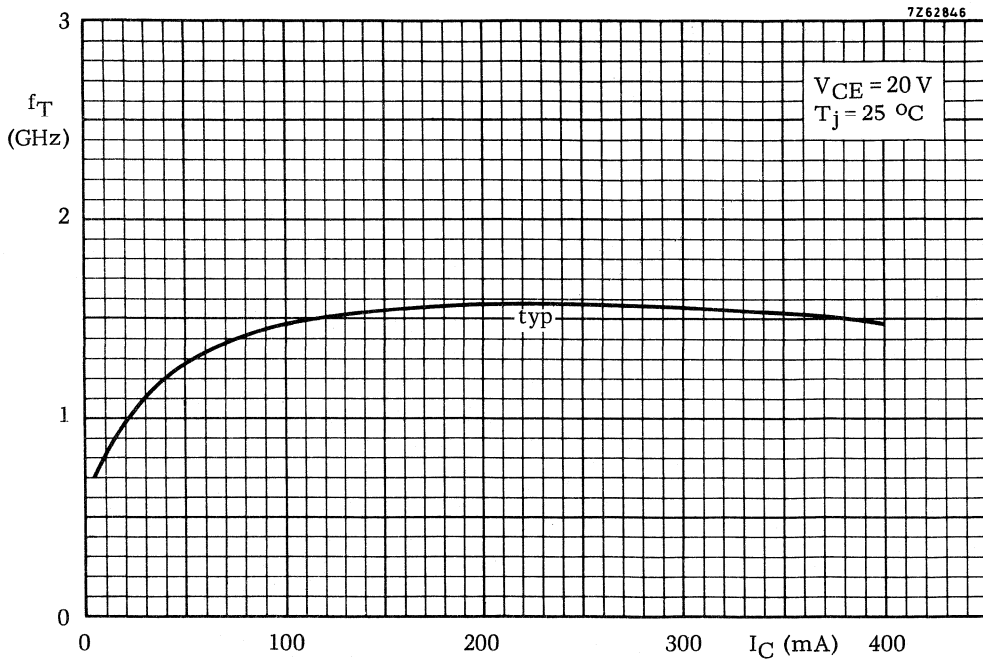
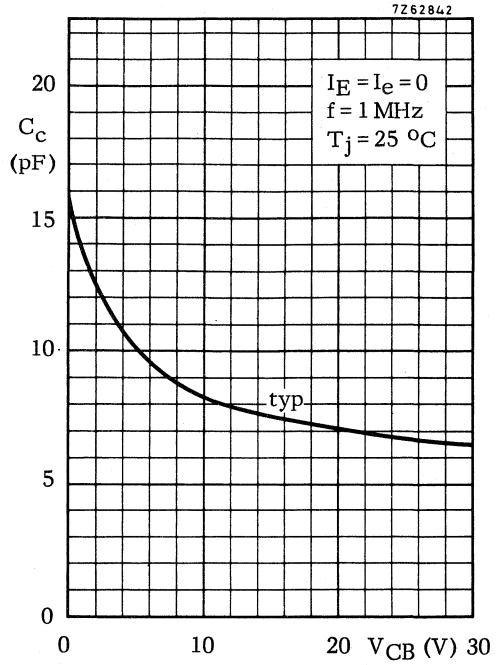
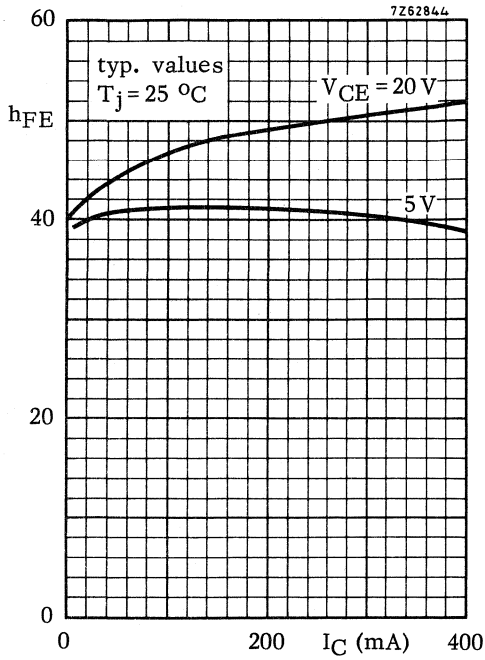
Feedback capacitance at  $f = 1\text{ MHz}$ 

$I_C = 10\text{ mA}; V_{CE} = 20\text{ V}; T_{mb} = 25\text{ }^\circ\text{C}$

$C_{re} \text{ typ. } 3,5\text{ pF}$

Collector-stud capacitance

$C_{cs} \text{ typ. } 2\text{ pF}$



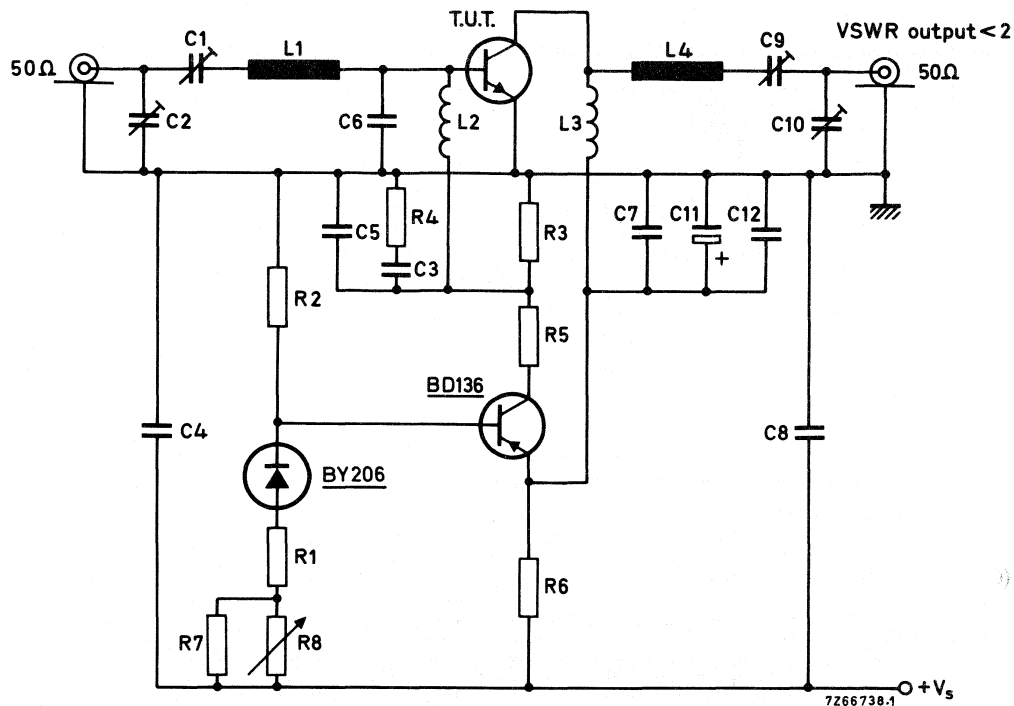


## APPLICATION INFORMATION

$d_{im}$ (dB) *	$f_{vision}$ (MHz)	$V_{CE}$ (V)	$I_C$ (mA)	$G_p$ (dB)	$P_o$ sync (W) *	$T_h$ (°C)
-60	860	25	250	> 6	> 0,5	25
-60	860	25	250	typ. 7	typ. 0,6	25

\*) Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

Test circuit at  $f_{vision} = 860$  MHz



List of components:

- $C1 = C2 = C10 = 2$  to 9 pF film dielectric trimmers  
 $C3 = C4 = C12 = 100$  nF polyester capacitors  
 $C5 = C7 = C8 = 100$  pF feed-through capacitors  
 $C6 = 2 \times 2,7$  pF in parallel, chip capacitors  
 $C9 = 2$  to 18 pF film dielectric trimmer  
 $C11 = 10$   $\mu$ F/40 V solid aluminium electrolytic capacitor  
 $R1 = 220 \Omega$   
 $R2 = 4,7$  k $\Omega$   
 $R3 = 100 \Omega$   
 $R4 = 10 \Omega$   
 $R5 = 470 \Omega$  (1 W)  
 $R6 = 3 \times 22 \Omega$  in parallel; (1 W)  
 $R7 = 12$  k $\Omega$   
 $R8 = 1$  k $\Omega$

**APPLICATION INFORMATION** (continued)

List of components: (continued)

L1 = stripline (14,8 mm x 4,3 mm)

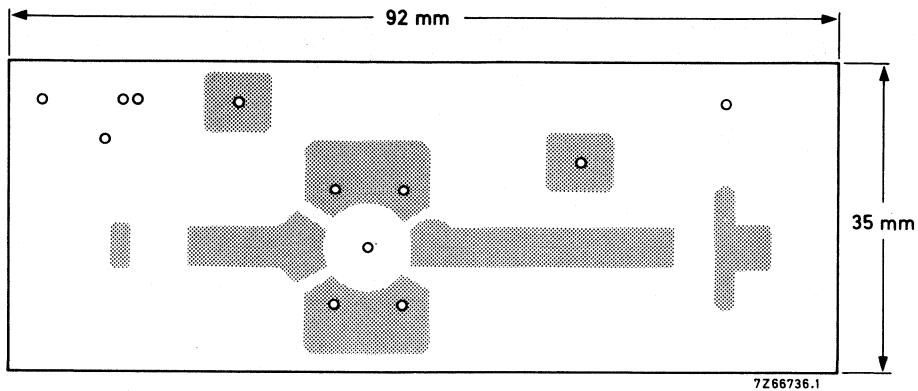
L2 = 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm

L3 = 2 turns Cu wire (1 mm); winding pitch 1,5 mm; int. dia. 4,5 mm; leads 2 x 5 mm

L4 = stripline (29,5 mm x 4,3 mm)

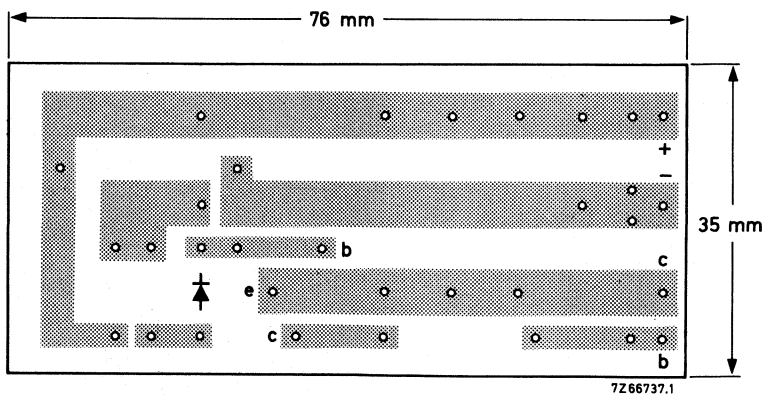
L1 and L4 are striplines on a double Cu-clad print plate with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1,45 mm.

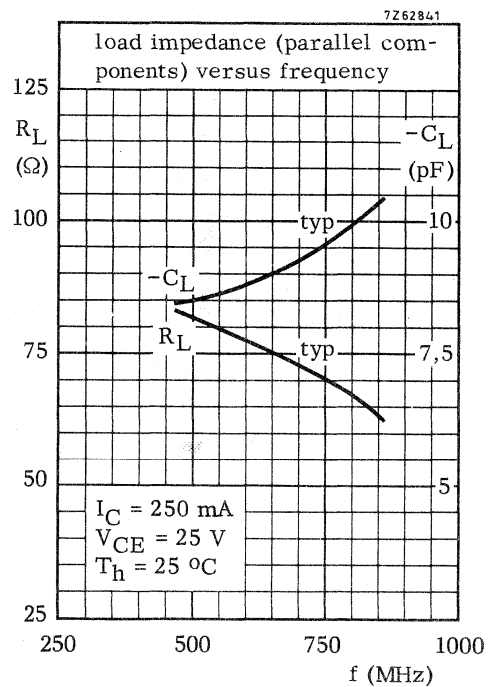
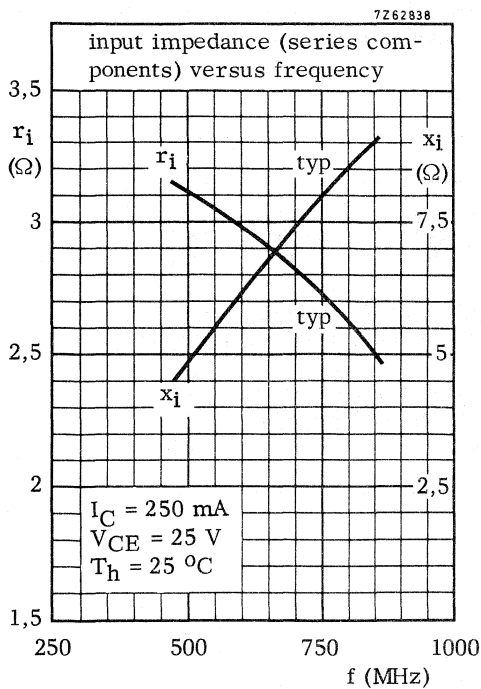
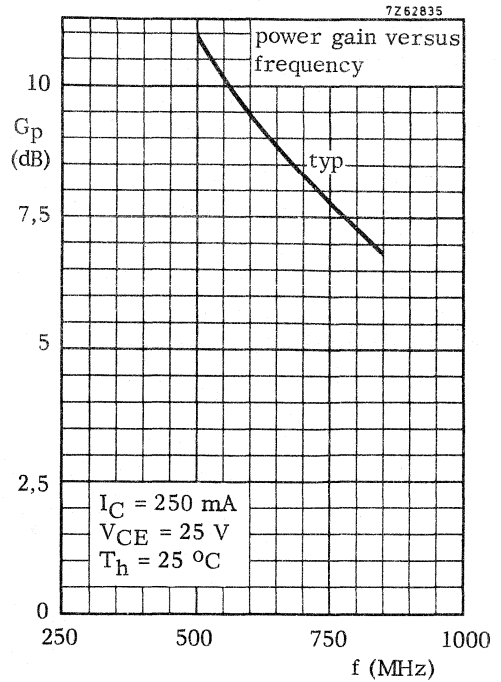
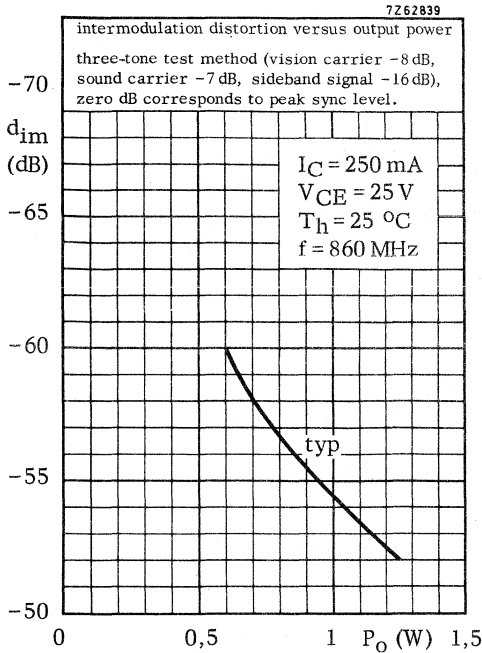
Layout of printed-circuit board for 860 MHz test circuit.



The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.

Layout of printed board bias circuit.







## U.H.F. LINEAR POWER TRANSISTOR

N-P-N multi-emitter silicon planar epitaxial transistor primarily for use in linear u.h.f. amplifiers for television transposers and transmitters.

**Features:**

- guaranteed low intermodulation figures;
- gold metallization ensures excellent reliability.

The transistor has a ¼" capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

R.F. performance in linear amplifier

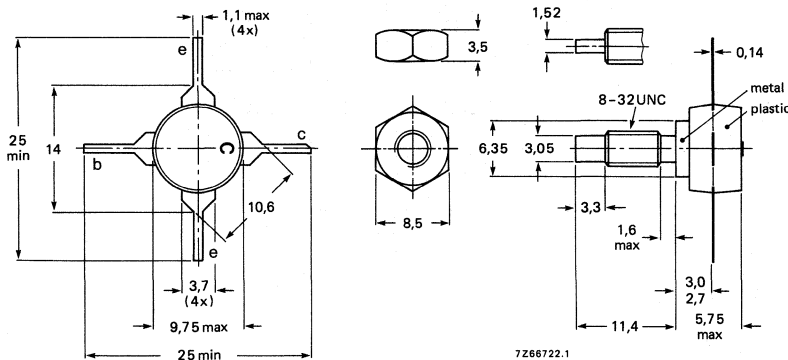
mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ mA	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{o sync}}^*$ W	$G_{\text{p}}$ dB
class-A	860	25	500	25	-60	> 1,0	> 5,5
class-A	860	25	500	25	-60	typ. 1,1	typ. 6,5

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/3.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

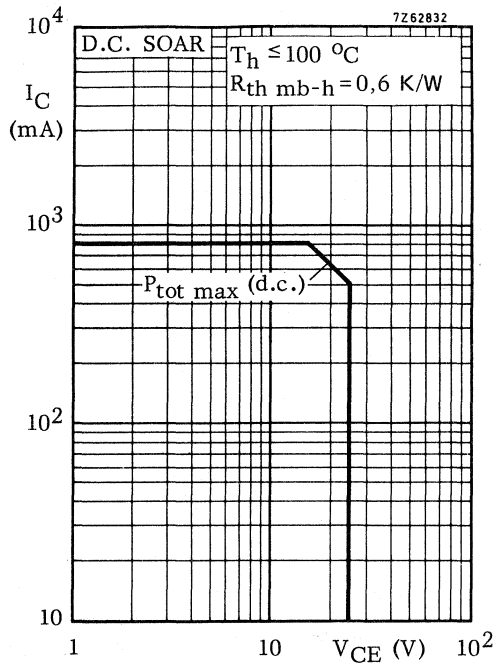
Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter; peak value)	$V_{CBOM}$	max.	40	V
Collector-emitter voltage ( $R_{BE} = 10 \Omega$ ; peak value)	$V_{CERM}$	max.	40	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	27	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	3,5	V
Collector current (d.c.)	$I_C$	max.	0,8	A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	2	A
Total power dissipation up to $T_h = 100 \text{ }^\circ\text{C}$	$P_{tot}$	max.	12,5	W



Storage temperature	$T_{stg}$	-65 to +200	$^\circ\text{C}$
Junction temperature	$T_j$	max. 200	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th j-mb}$	=	7,5	K/W
From mounting base to heatsink	$R_{th mb-h}$	=	0,6	K/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20\text{ V}$	$I_{CBO}$	<	200	$\mu\text{A}$
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Breakdown voltages

Collector-base voltage

open emitter; $I_C = 2\text{ mA}$	$V_{(BR)CBO}$	>	40	V
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Collector-emitter voltage

$R_{BE} = 10\ \Omega; I_C = 10\text{ mA}$	$V_{(BR)CER}$	>	40	V
-------------------------------------------	---------------	---	----	---

open base; $I_C = 10\text{ mA}$	$V_{(BR)CEO}$	>	27	V
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Emitter-base voltage

open collector; $I_E = 2\text{ mA}$	$V_{(BR)EBO}$	>	3,5	V
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Saturation voltage

$I_C = 400\text{ mA}; I_B = 40\text{ mA}$	$V_{CEsat}$	<	0,75	V
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D.C. current gain

$I_C = 400\text{ mA}; V_{CE} = 20\text{ V}$	$h_{FE}$	>	30	
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$I_C = 800\text{ mA}; V_{CE} = 20\text{ V}$	$h_{FE}$	>	20	
---------------------------------------------	----------	---	----	--

Transition frequency

$I_C = 400\text{ mA}; V_{CE} = 20\text{ V}$	$f_T$	>	1,2	GHz
---------------------------------------------	-------	---	-----	-----

$I_C = 700\text{ mA}; V_{CE} = 20\text{ V}$	$f_T$	>	1,0	GHz
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Collector capacitance at  $f = 1\text{ MHz}$ 

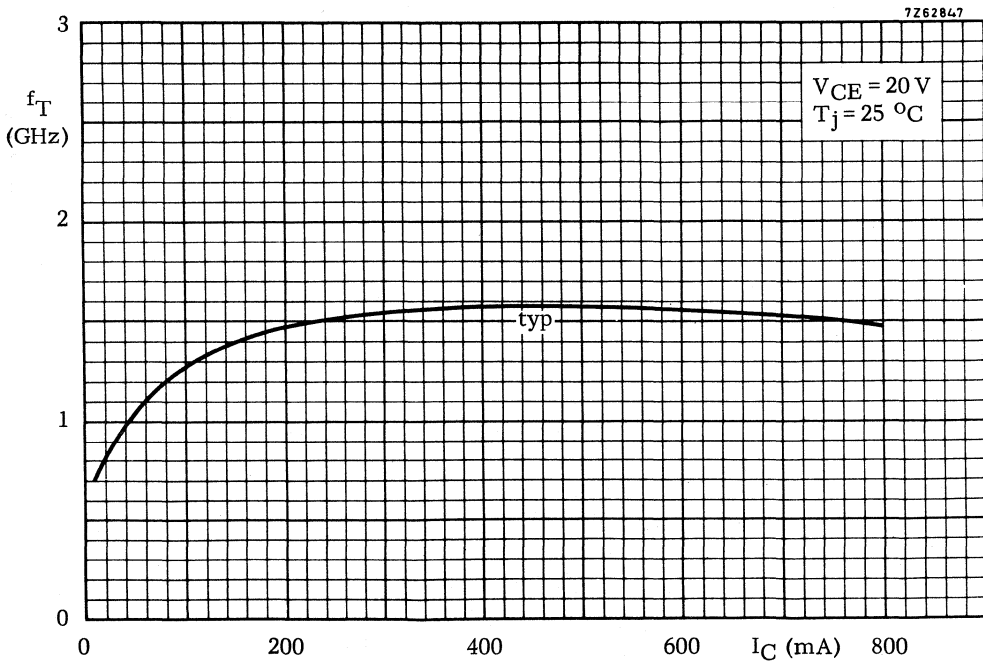
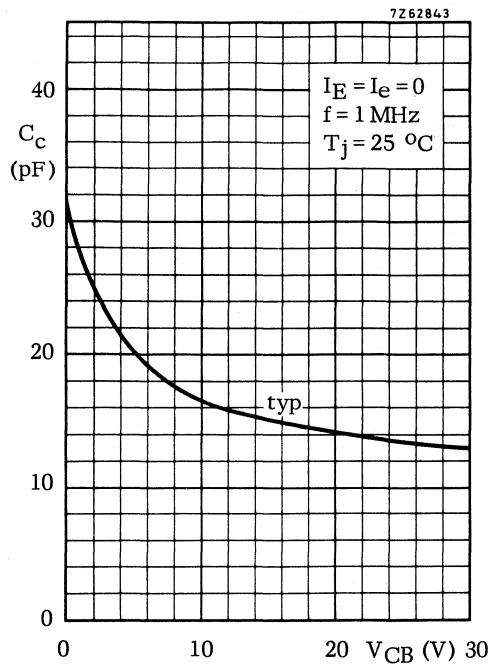
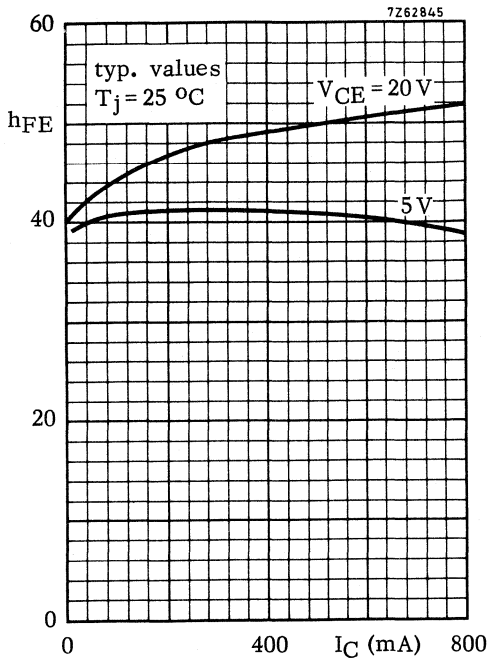
$I_E = I_e = 0; V_{CB} = 20\text{ V}$	$C_c$	<	20	pF
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Feedback capacitance at  $f = 1\text{ MHz}$ 

$I_C = 20\text{ mA}; V_{CE} = 20\text{ V}; T_{mb} = 25\text{ }^\circ\text{C}$	$C_{re}$	typ.	7	pF
-------------------------------------------------------------------------------	----------	------	---	----

Collector-stud capacitance

	$C_{cs}$	typ.	2	pF
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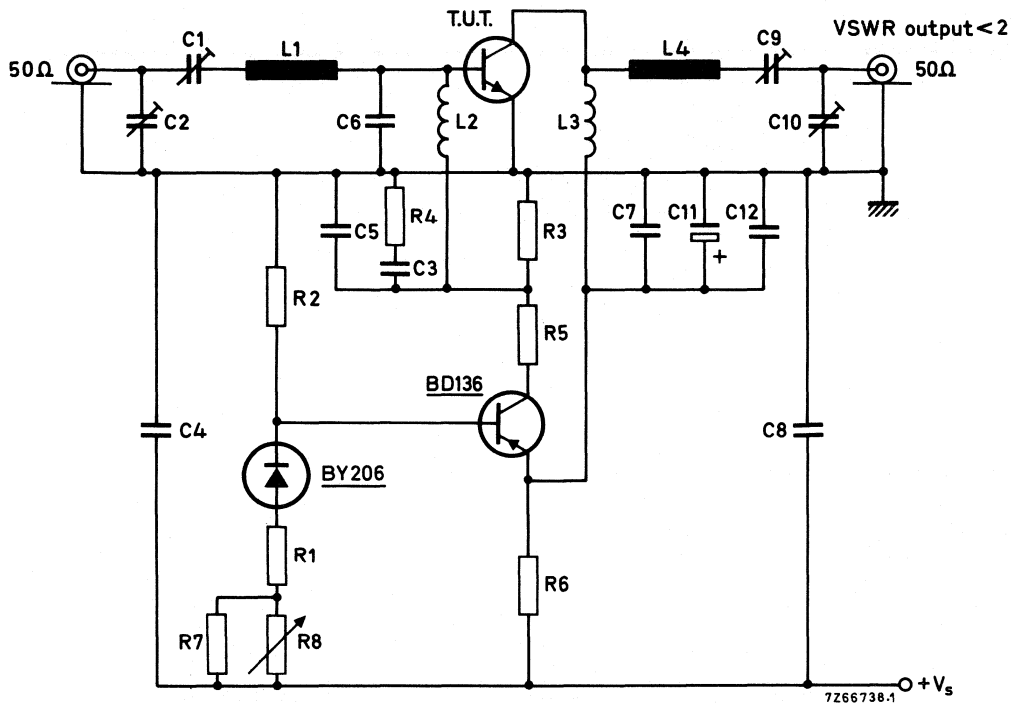


## APPLICATION INFORMATION

$d_{im}$ (dB) *	$f_{vision}$ (MHz)	$V_{CE}$ (V)	$I_C$ (mA)	$G_p$ (dB)	$P_{O\ sync}$ (W) *	$T_h$ (°C)
-60	860	25	500	> 5,5	> 1,0	25
-60	860	25	500	typ. 6,5	typ. 1,1	25

\*) Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

Test circuit at  $f_{vision} = 860$  MHz



List of components: (see also next page).

C1 = C2 = C10 = 2 to 9 pF film dielectric trimmers

C3 = C4 = C12 = 100 nF polyester capacitors

C5 = C7 = C8 = 100 pF feed-through capacitors

C6 = 2 x 2,7 pF in parallel, chip capacitors

C9 = 2 to 18 pF film dielectric trimmer

C11 = 10  $\mu$ F/40 V solid aluminium electrolytic capacitor

R1 = 220  $\Omega$

R2 = 4,7 k $\Omega$

R3 = 100  $\Omega$

R4 = 10  $\Omega$

R5 = 470  $\Omega$  (1 W)

R6 = 3 x 22  $\Omega$  in parallel; (1 W)

R7 = 12 k $\Omega$

R8 = 1 k $\Omega$

**APPLICATION INFORMATION** (continued)

List of components: (continued)

L1 = stripline (14,8 mm x 4,3 mm)

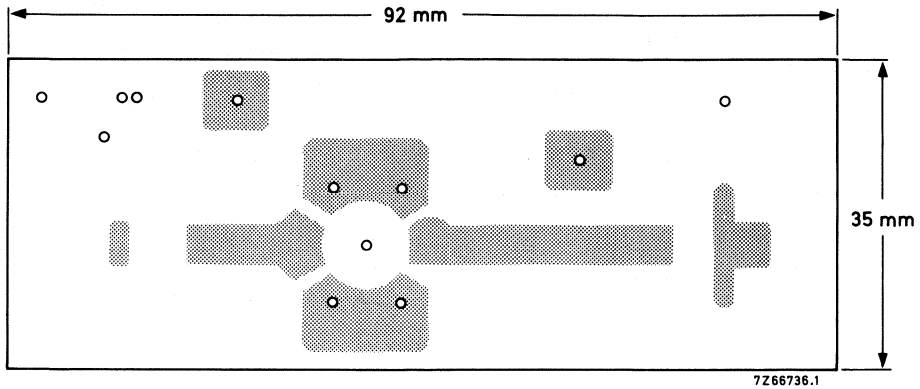
L2 = 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm

L3 = 2 turns Cu wire (1 mm); winding pitch 1,5 mm; int. dia. 4,5 mm; leads 2 x 5 mm

L4 = stripline (29,5 mm x 4,3 mm)

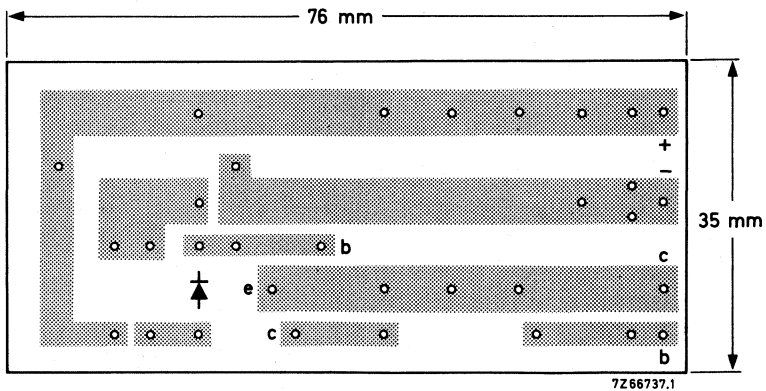
L1 and L4 are striplines on a double Cu-clad print plate with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1,45 mm.

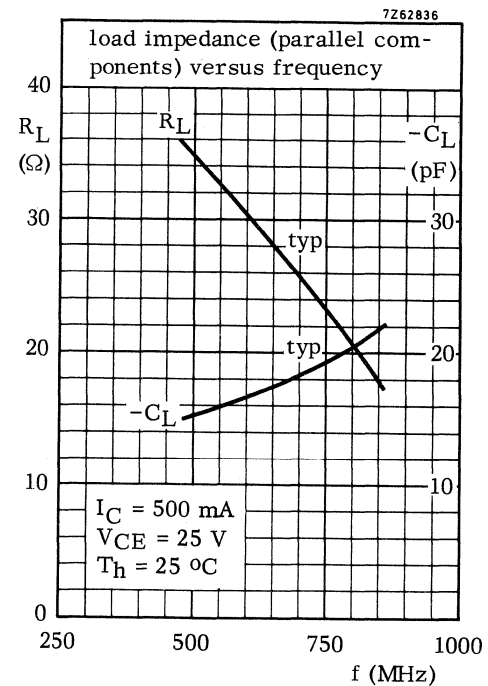
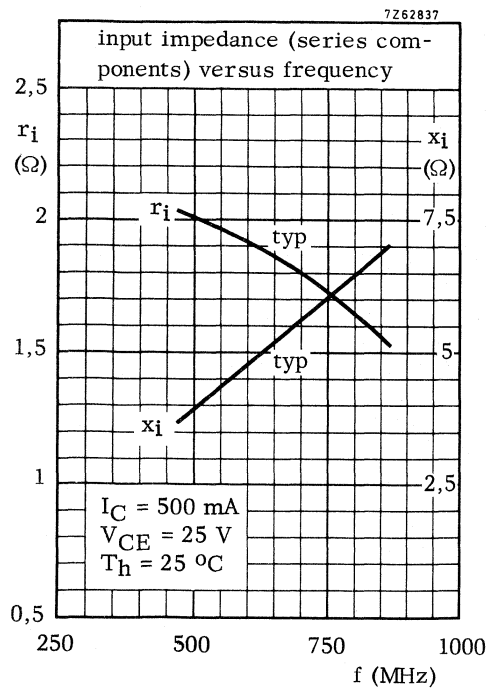
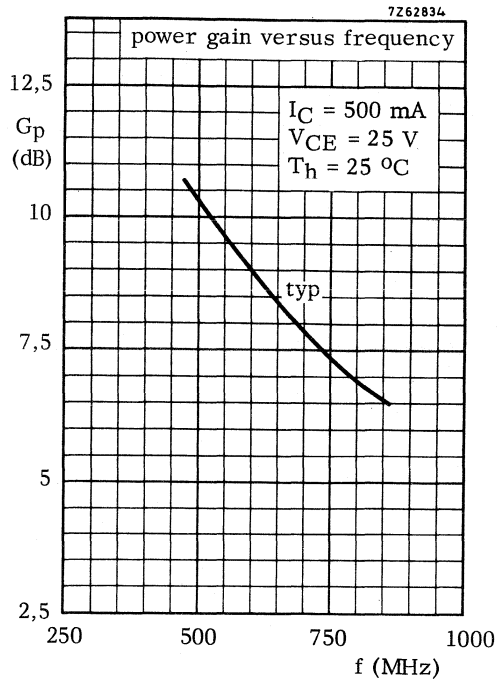
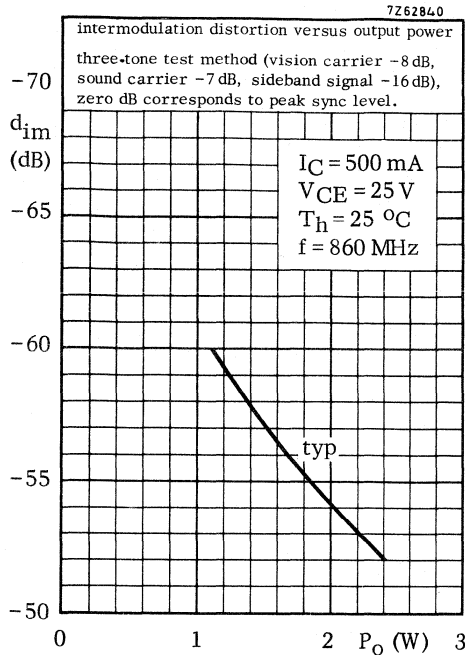
Layout of printed-circuit board for 860 MHz test circuit.



The circuit and the components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.

Layout of printed board bias circuit.







## U.H.F. LINEAR POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in linear u.h.f. amplifiers of television transposers and transmitters in band IV-V.

### Features:

- diffused emitter ballasting resistors for an optimum temperature profile;
- gold metallization ensures excellent reliability.

The transistor has a ¼" capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

#### R.F. performance in linear amplifier

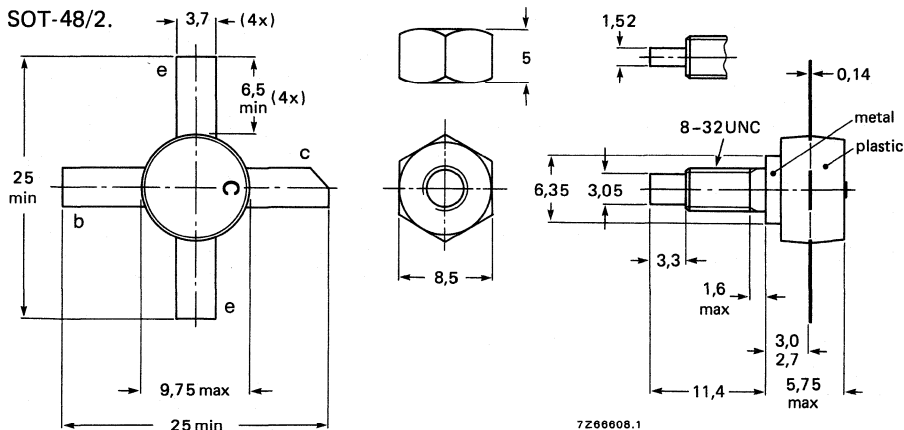
mode of operation	$f_{\text{vision}}$ MHz	$V_{\text{CE}}$ V	$I_{\text{C}}$ mA	$T_{\text{h}}$ °C	$d_{\text{im}}^*$ dB	$P_{\text{o sync}}^*$ W	$G_{\text{p}}$ dB
class-A	860	25	850	70	-60	> 3,5	> 5,0
class-A	860	25	850	70	-60	typ. 4,0	typ. 5,5

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/2.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or  
countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage

(peak value);  $V_{BE} = 0$

open base

Emitter-base voltage (open collector)

Collector current

d.c.

(peak value);  $f > 1$  MHz

Total power dissipation at  $T_h = 70$  °C

Storage temperature

Junction temperature

$V_{CESM}$  max. 50 V

$V_{CEO}$  max. 27 V

$V_{EBO}$  max. 3,5 V

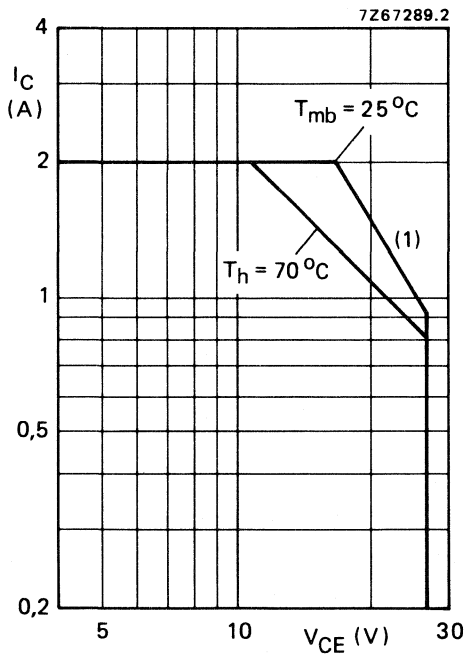
$I_C$  max. 2 A

$I_{CM}$  max. 4 A

$P_{tot}$  max. 21,5 W

$T_{stg}$  -65 to + 200 °C

$T_j$  max. 200 °C



(1) Second breakdown limit (independent of temperature).

Fig. 2 D.C. SOAR.

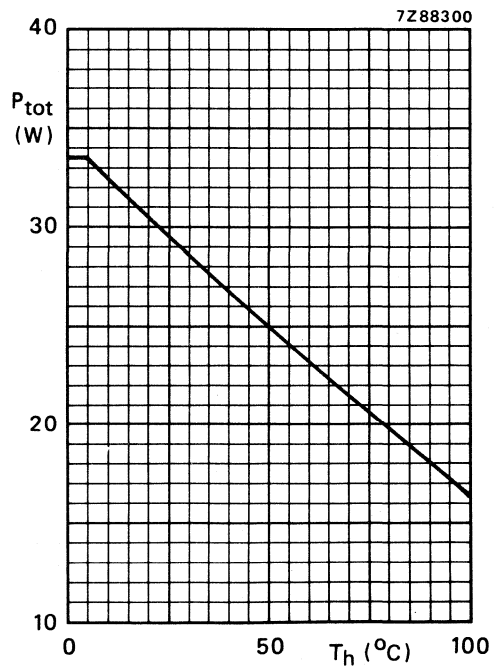


Fig. 3 Power derating curve vs. temperature.

**THERMAL RESISTANCE** (dissipation = 21,25 W;  $T_{mb} = 82,75$  °C, i.e.  $T_h = 70$  °C).

From junction to mounting base

$R_{th\ j-mb} = 5,45$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0,6$  K/W

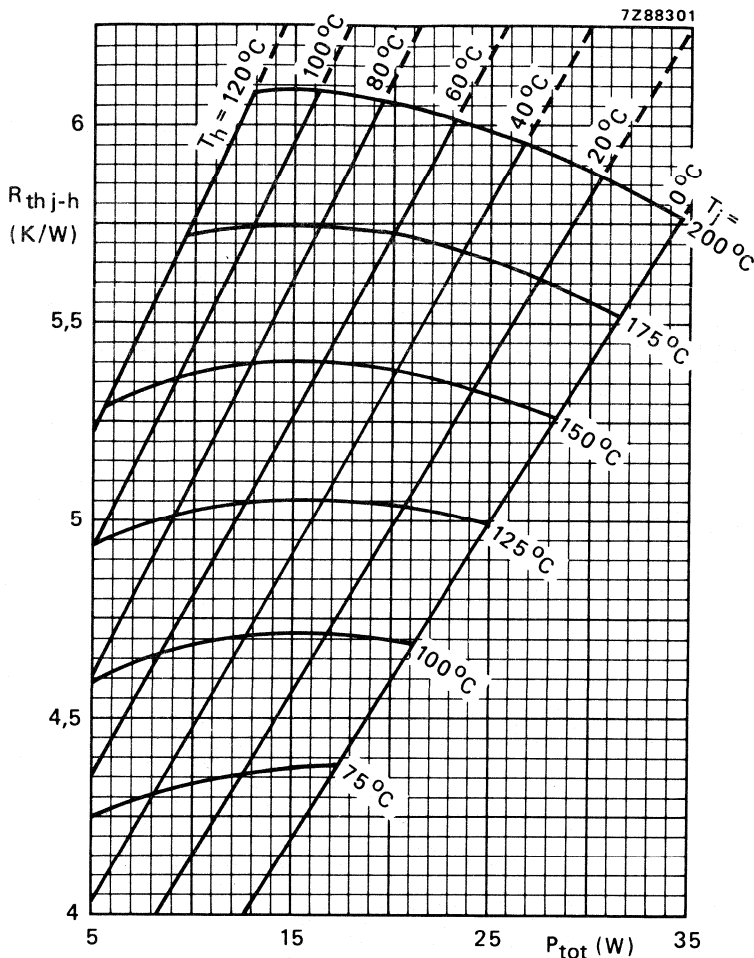


Fig. 4 Maximum thermal resistance from junction to heatsink as a function of power dissipation, with heatsink and junction temperature as parameters. ( $R_{th\ mb-h} = 0,6\ K/W.$ )

**Example**

Nominal class-A operation (without r.f. signal):  $V_{CE} = 25\ V$ ;  $I_C = 850\ mA$ ;  $T_h = 70\ ^\circ C$ .

Fig. 4 shows:  $R_{th\ j-h}$  max. 6,05 K/W  
 $T_j$  max. 200 °C

Typical device:  $R_{th\ j-h}$  typ. 5,35 K/W  
 $T_j$  typ. 183 °C

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector-emitter breakdown voltage

$V_{BE} = 0; I_C = 10\text{ mA}$

open base;  $I_C = 25\text{ mA}$

$V_{(BR)CES} > 50\text{ V}$

$V_{(BR)CEO} > 27\text{ V}$

Emitter-base breakdown voltage

open collector;  $I_E = 5\text{ mA}$

$V_{(BR)EBO} > 3,5\text{ V}$

D.C. current gain\*

$I_C = 850\text{ mA}; V_{CE} = 25\text{ V}$

$h_{FE} > 15$   
typ. 40

Collector-emitter saturation voltage\*

$I_C = 500\text{ mA}; I_B = 100\text{ mA}$

$V_{CEsat}$  typ. 0,25 V

Transition frequency at  $f = 500\text{ MHz}$ \*\*

$-I_E = 850\text{ mA}; V_{CB} = 25\text{ V}$

$f_T$  typ. 2,5 GHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 25\text{ V}$

$C_c$  typ. 24 pF  
< 30 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 50\text{ mA}; V_{CE} = 25\text{ V}$

$C_{re}$  typ. 15 pF

Collector-stud capacitance

$C_{cs}$  typ. 2 pF

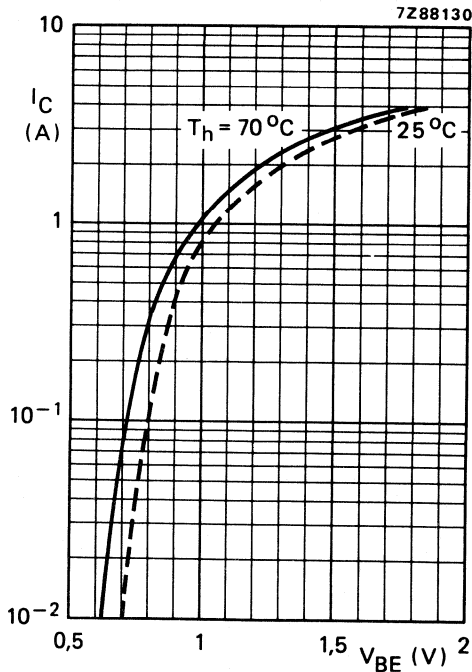


Fig. 5 Typical values;  $V_{CE} = 25\text{ V}$ .

\* Measured under pulse conditions:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0,02$ .

\*\* Measured under pulse conditions:  $t_p \leq 50\text{ }\mu\text{s}; \delta \leq 0,01$ .



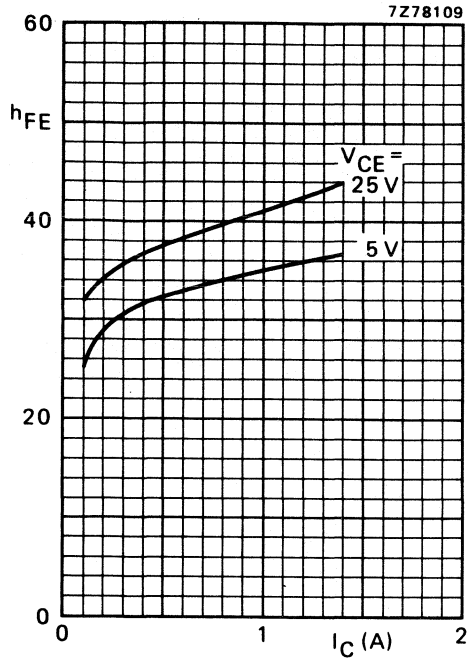


Fig. 6 Typical values;  $T_j = 25^\circ\text{C}$ .

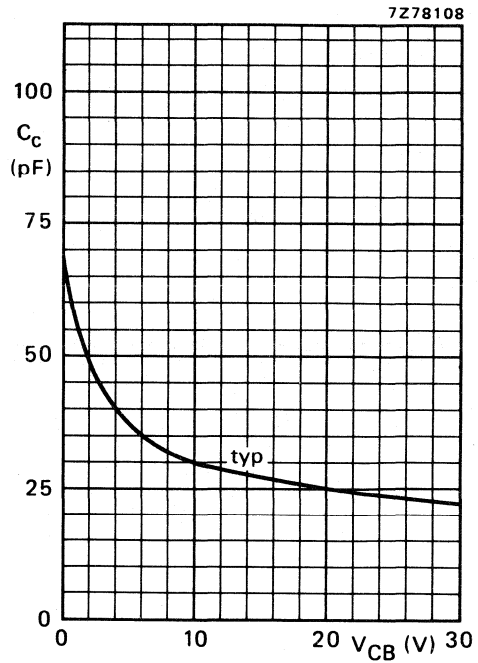


Fig. 7  $I_E = I_e = 0$ ;  $f = 1$  MHz;  $T_j = 25^\circ\text{C}$ .

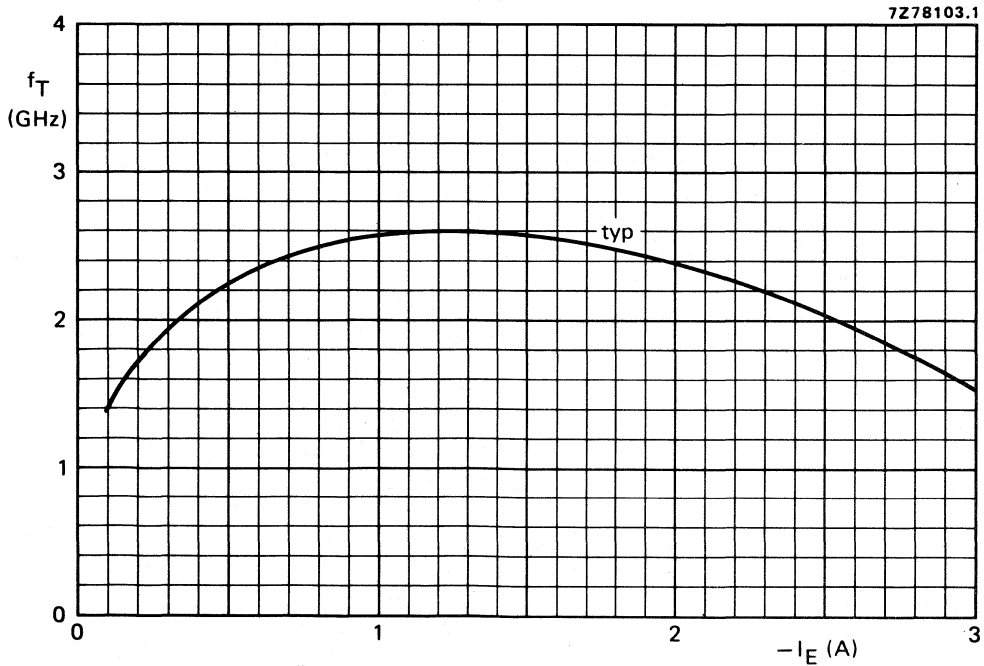


Fig. 8  $V_{CB} = 25$  V;  $f = 500$  MHz;  $T_j = 25^\circ\text{C}$ .

**APPLICATION INFORMATION**

R.F. performance in u.h.f. class-A operation (linear power amplifier)

$f_{\text{vision}}$ (MHz)	$V_{\text{CE}}$ (V)	$I_{\text{C}}$ (mA)	$T_{\text{h}}$ (°C)	$d_{\text{im}}$ (dB)*	$P_{\text{O sync}}$ (W)*	$G_{\text{p}}$ (dB)
860	25	850	70	-60	> 3,5	> 5,0
860	25	850	70	-60	typ. 4,0	typ. 5,5

\* Three-tone test method (vision carrier -8 dB, sound carrier -7 dB, sideband signal -16 dB), zero dB corresponds to peak sync level.

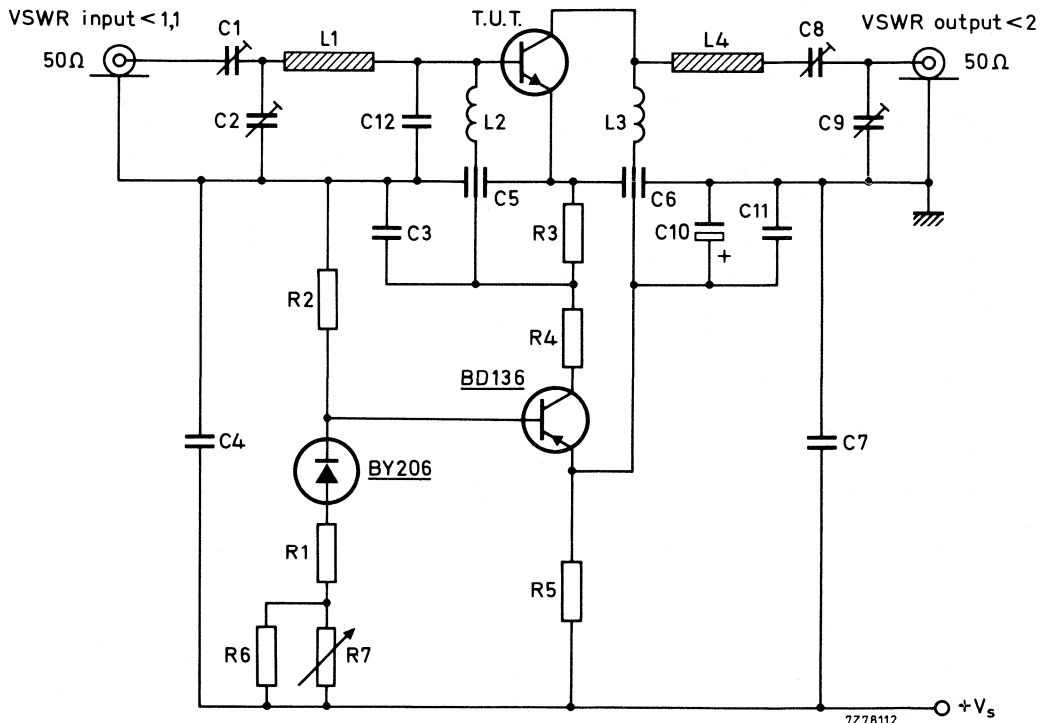


Fig. 9 Class-A test circuit at  $f_{\text{vision}} = 860$  MHz.

List of components:

- C1 = C2 = 1,4 to 5,5 pF film dielectric trimmer (cat.no. 2222 809 09001)
- C3 = C4 = 100 nF polyester capacitor
- C5 = C6 = 1 nF feed-through capacitor
- C7 = 5,6 pF ceramic capacitor
- C8 = 2 to 18 pF film dielectric trimmer (cat. no. 2222 809 09003)
- C9 = 2 to 9 pF film dielectric trimmer (cat. no. 2222 809 09002)
- C10 = 10 μF/40 V solid aluminium electrolytic capacitor
- C11 = 470 nF polyester capacitor
- C12 = 2 x 3,3 pF chip capacitors (in parallel)

## List of components: (continued)

R1 = 150  $\Omega$  carbon resistor (0,25 W)R2 = 1,8 k $\Omega$  carbon resistor (0,5 W)R3 = 33  $\Omega$  carbon resistor (0,5 W)R4 = 220  $\Omega$  carbon resistor (1 W)

L1 = stripline (13,6 mm x 6,9 mm)

L2 = microchoke 0,47  $\mu$ H (cat. no. 4322 057 04770)

L3 = 1 turn Cu wire (1 mm); internal diameter 5,5 mm; leads 2 x 5 mm

L4 = stripline (40,8 mm x 6,9 mm)

R5 = 4 x 12  $\Omega$  carbon resistors in parallel (1 W each)R6 = 1 k $\Omega$  carbon resistor (0,25 W)R7 = 220  $\Omega$  carbon potentiometer (0,25 W)

L1 and L4 are striplines on a double Cu-clad printed-circuit board with PTFE fibre-glass dielectric ( $\epsilon_r = 2,74$ ); thickness 1,5 mm.

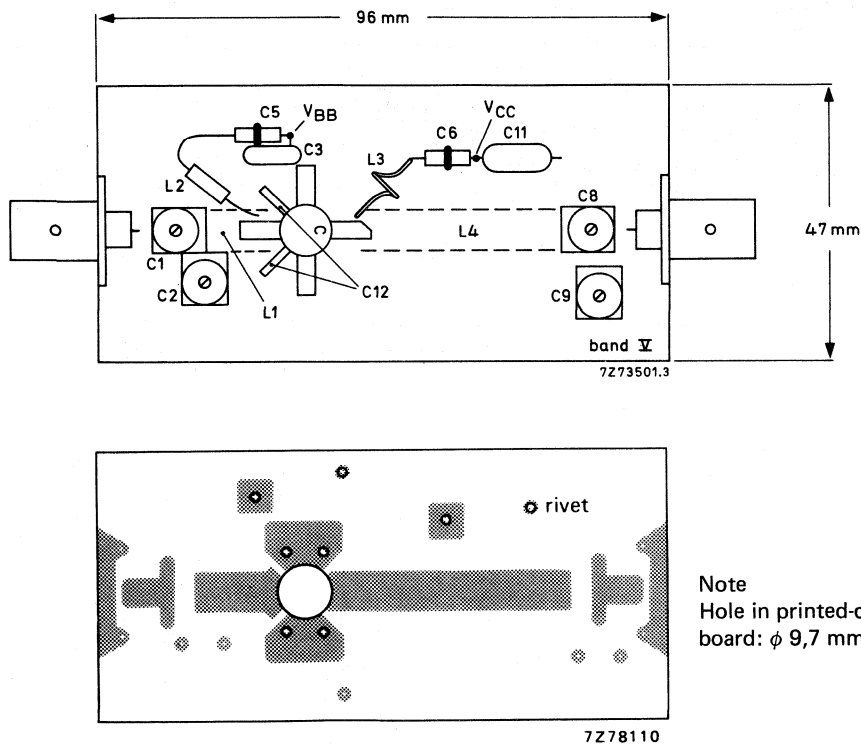


Fig. 10 Component layout and printed-circuit board for 860 MHz class-A test circuit.

The circuit and the components are on one side of the PTFE fibre-glass board, the other side is unetched copper to serve as a ground-plane. Earth connections are made by hollow rivets. Additionally copper straps are used under the emitters and at the input and output to provide direct contact between the copper on the component side and the ground-plane.

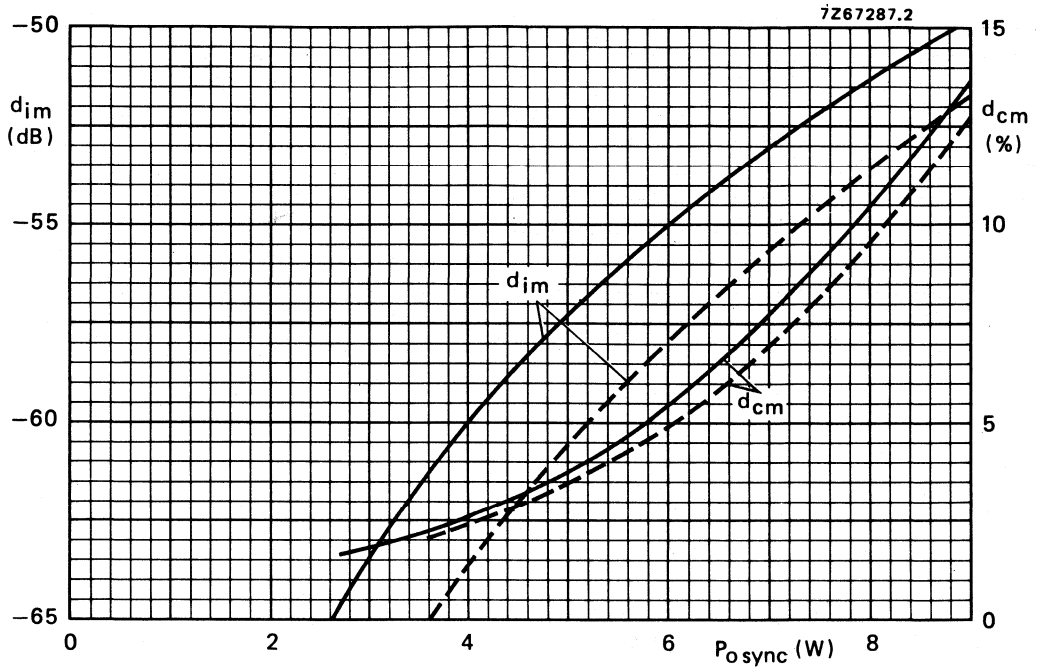


Fig. 11 Intermodulation distortion ( $d_{im}$ )\* and cross-modulation distortion ( $d_{cm}$ )\*\* as a function of  $P_{0\text{ sync}}$ . Typical values;  $V_{CE} = 25\text{ C}$ ;  $I_C = 850\text{ mA}$ ; ---  $T_h = 25\text{ °C}$ ; —  $T_h = 70\text{ °C}$ ;  $f_{\text{vision}} = 860\text{ MHz}$ .

\* Three-tone test method (vision carrier  $-8\text{ dB}$ , sound carrier  $-7\text{ dB}$ , sideband signal  $-16\text{ dB}$ ), zero dB corresponds to peak sync level.

Intermodulation distortion of input signal  $\leq -75\text{ dB}$ .

\*\* Two-tone test method (vision carrier  $0\text{ dB}$ , sound carrier  $-7\text{ dB}$ ), zero dB corresponds to peak sync level.

Cross-modulation distortion ( $d_{cm}$ ) is the voltage variation (%) of sound carrier when vision carrier is switched from  $0\text{ dB}$  to  $-20\text{ dB}$ .

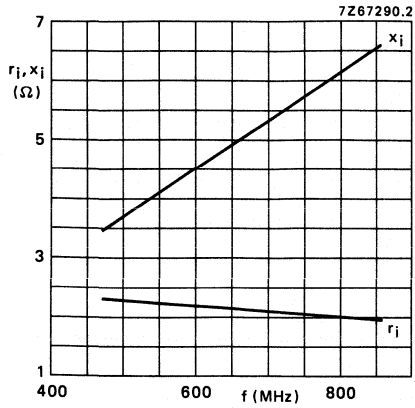


Fig. 12 Input impedance (series components).

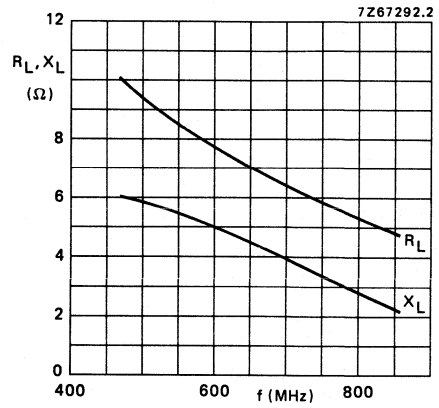


Fig. 13 Load impedance (series components).

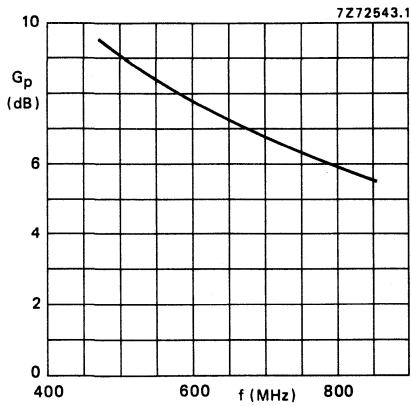


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 25$  V;  $I_C = 850$  mA; class-A operation;  $T_h = 70$  °C.



### V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in class-A, B and C operated mobile and military transmitters with a supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 1/4" capstan envelope with a moulded cap. All leads are isolated from the stud.

#### QUICK REFERENCE DATA

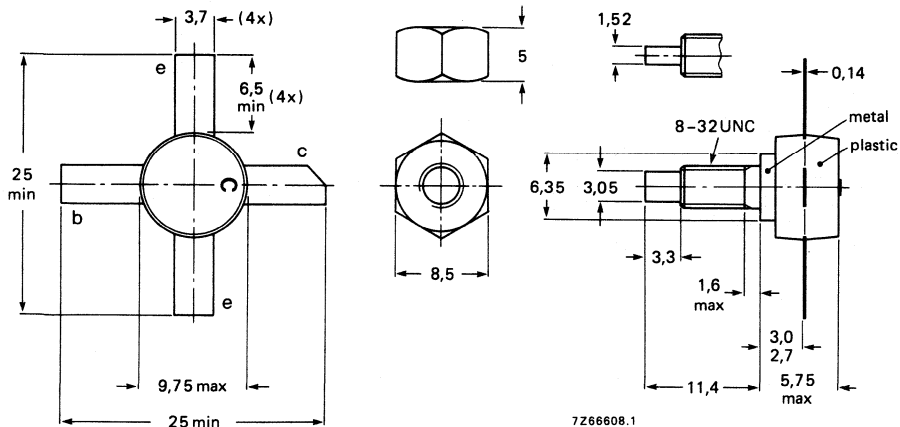
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	8	> 9	> 70	2,8 + j1,2	76 - j16
c.w.	12,5	175	8	typ. 9	typ. 70	—	—

#### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/2.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)  
peak value

$V_{CBOM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

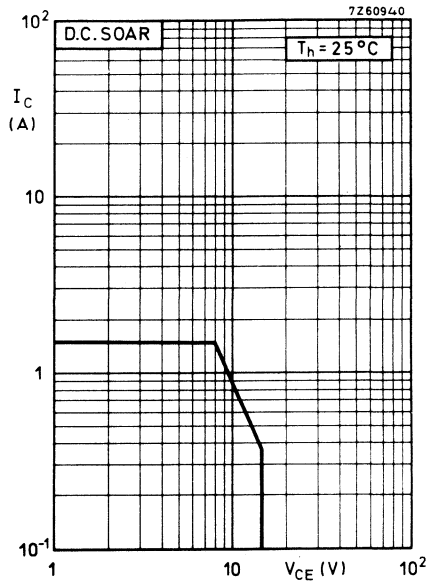
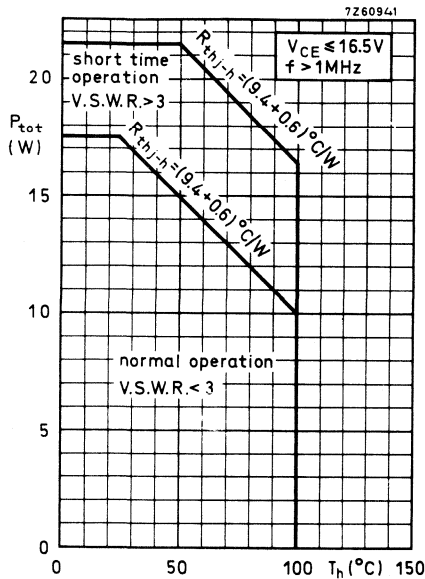
$I_{C(AV)}$  max. 1.25 A

Collector current (peak value)  $f > 1$  MHz

$I_{CM}$  max. 3.75 A

Total power dissipation up to  $T_h = 25^\circ\text{C}$   
 $f > 1$  MHz

$P_{tot}$  max. 17.5 W



Storage temperature

$T_{stg}$  -30 to +200  $^\circ\text{C}$

Operating junction temperature

$T_j$  max. 200  $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to mounting base

$R_{th\ j-mb} = 9.4$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0.6$  K/W



## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_B = 0; V_{CE} = 14\text{ V}$   $I_{CEO} < 5\text{ mA}$

Breakdown voltages

Collector-base voltage  
open emitter,  $I_C = 1\text{ mA}$

$V_{(BR)CBO} > 36\text{ V}$

Collector-emitter voltage  
open base,  $I_C = 10\text{ mA}$

$V_{(BR)CEO} > 18\text{ V}$

Emitter-base voltage  
open collector,  $I_E = 1\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Transient energy

$L = 25\text{ mH}; f = 50\text{ Hz}$

open base  $E > 0.5\text{ mS}$   
 $-V_{BE} = 1.5\text{ V}; R_{BE} = 33\ \Omega$   $E > 0.5\text{ mS}$

D. C. current gain

$I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$   $h_{FE} > 5$

Transition frequency

$I_C = 500\text{ mA}; V_{CE} = 10\text{ V}$   $f_T$  typ. 700 MHz

Collector capacitance at  $f = 1\text{ MHz}$

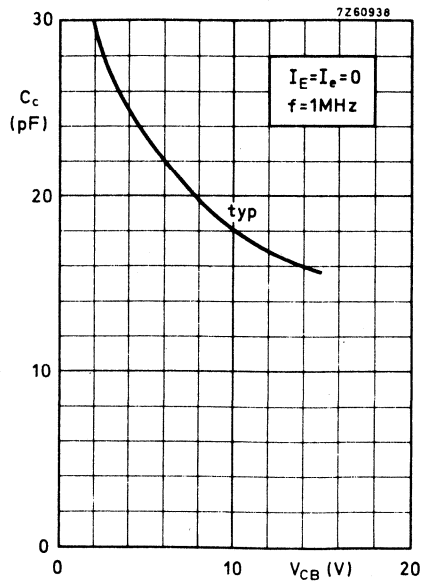
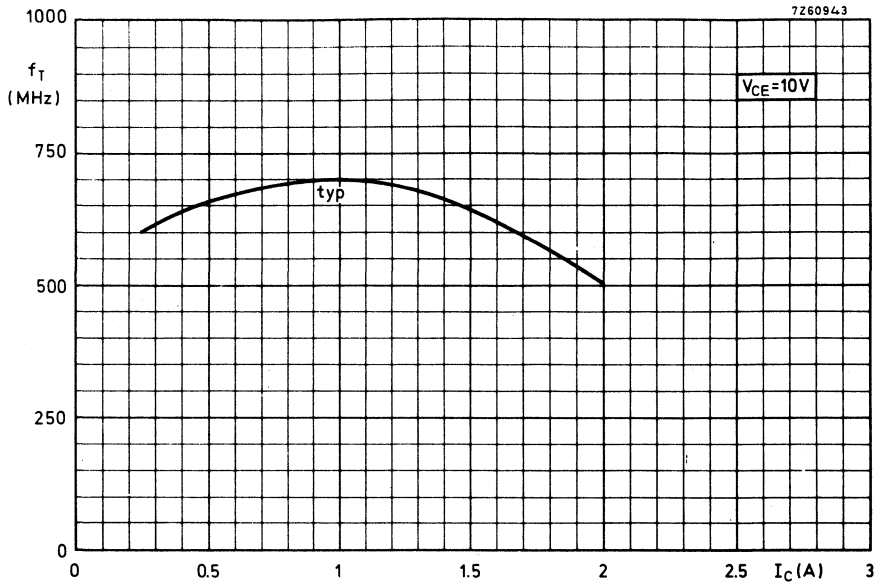
$I_E = I_e = 0; V_{CB} = 15\text{ V}$   $C_c$  typ. 15 pF  
< 20 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 100\text{ mA}; V_{CE} = 15\text{ V}$   $-C_{re}$  typ. 11 pF

Collector-stud capacitance

$C_{cs}$  typ. 2 pF



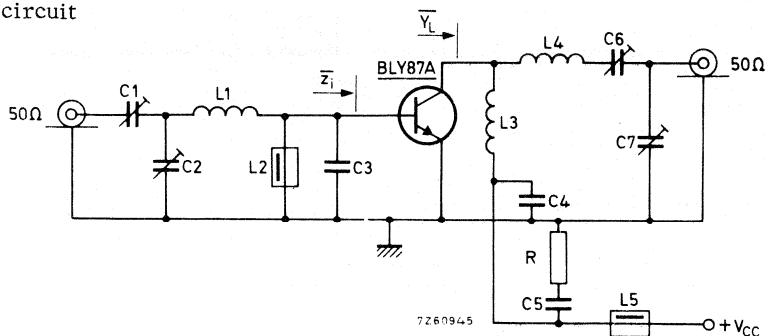
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

 $f = 175 \text{ MHz}$ ;  $T_{mb}$  up to  $25^\circ\text{C}$ 

$V_{CC}$ (V)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$Z_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
13.5	< 1.0	8	< 0.85	> 9	> 70	$2.8 + j1.2$	$76 - j16$
12.5	typ. 1.0	8	typ. 0.91	typ. 9	typ. 70	—	—

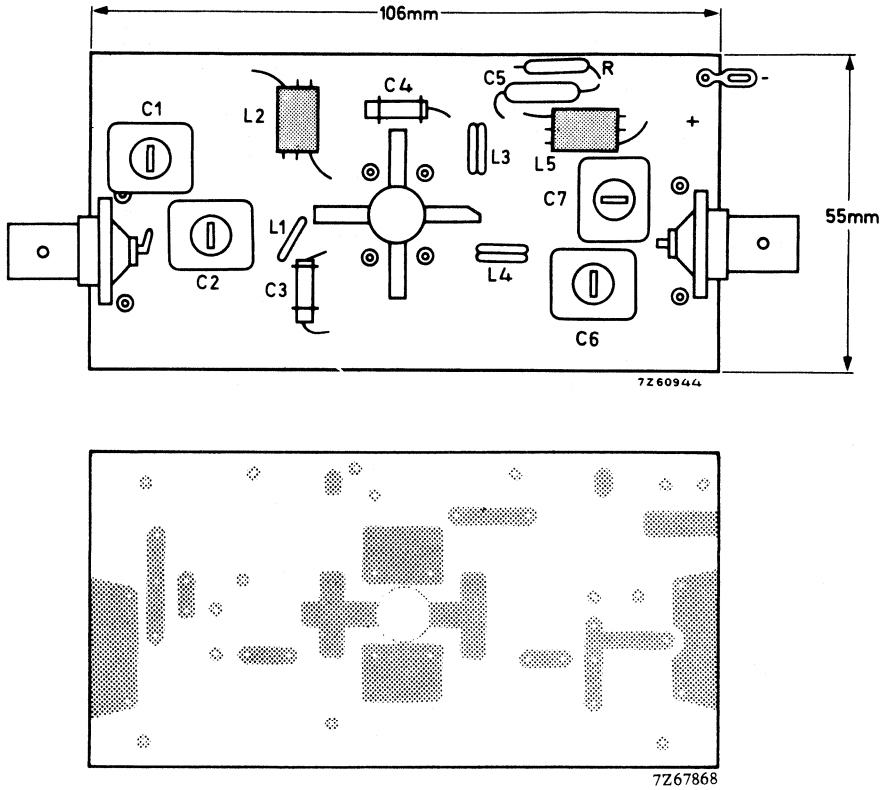
Test circuit



- $C1 =$  2.5 to 20 pF film dielectric trimmer (code number 2222 809 07004)  
 $C2 = C6 = C7 =$  4 to 40 pF film dielectric trimmer (code number 2222 809 07008)  
 $C3 =$  47 pF ceramic  
 $C4 =$  100 pF ceramic  
 $C5 =$  150 nF polyester  
 $L1 =$  0.5 turn enamelled Cu wire (1.5 mm); int. diam. 6 mm; leads 2 x 10 mm  
 $L2 = L5 =$  ferroxcube choke (code number 4312 020 36640)  
 $L3 =$  2.5 turns closely wound enamelled Cu wire (1.5 mm); int. diam. 6 mm; leads 2 x 10 mm  
 $L4 =$  4.5 turns enamelled Cu wire (1.5 mm); int. diam. 6 mm; leads 2 x 10 mm  
 $R = 10 \Omega$  carbon

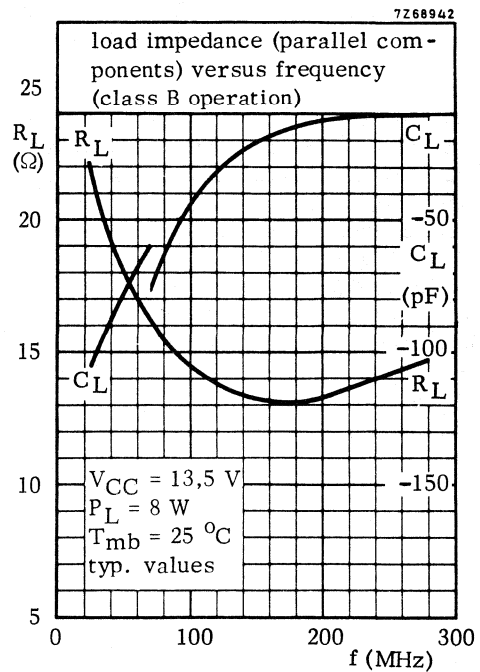
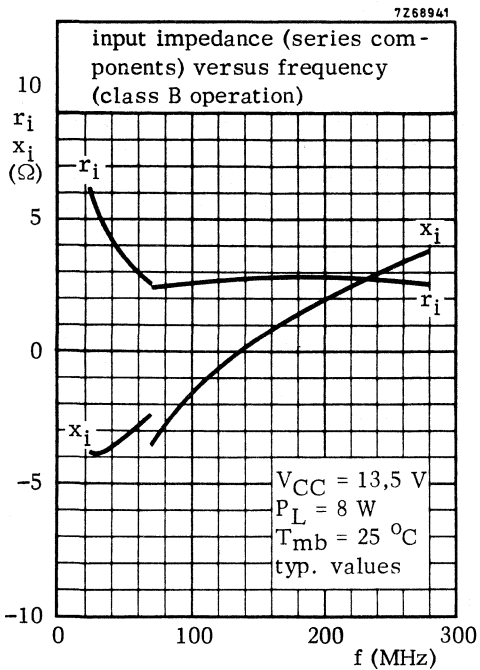
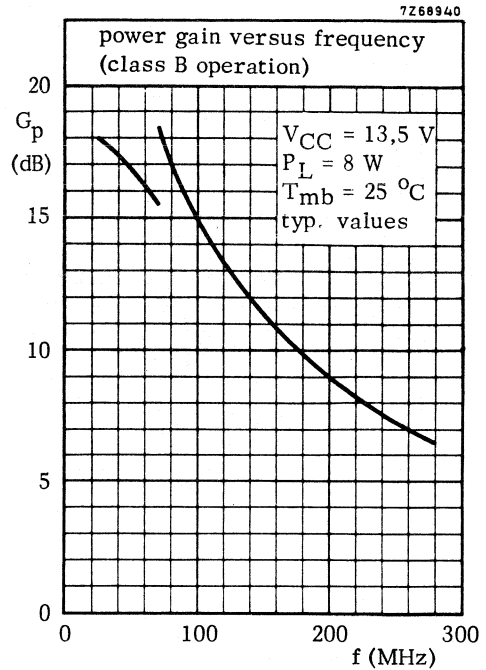
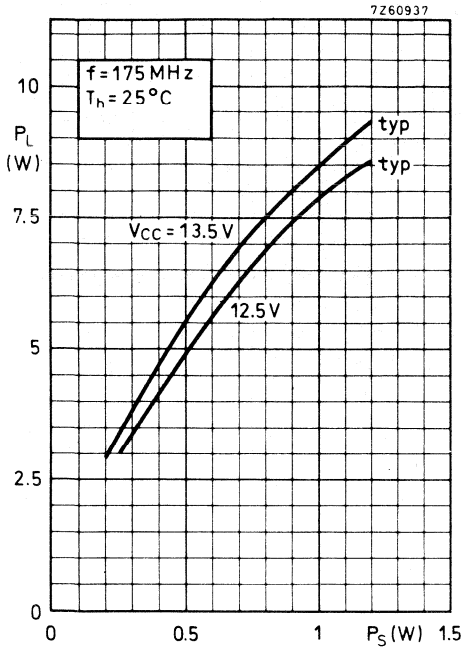
APPLICATION INFORMATION (continued)

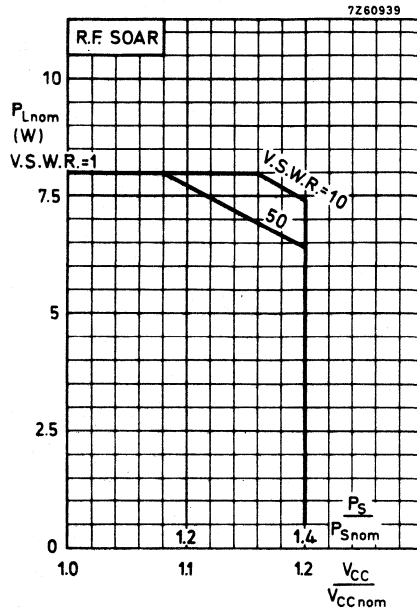
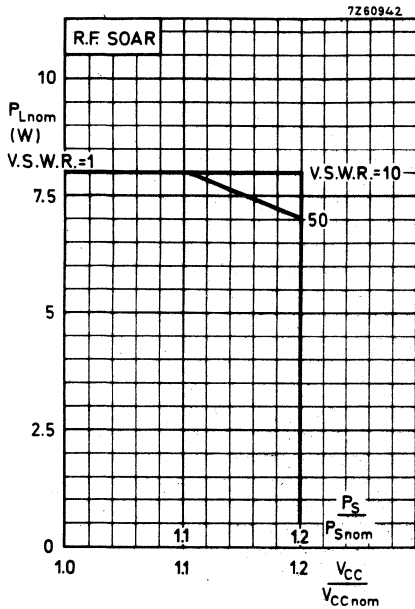
Component lay-out and printed circuit board for 175 MHz test circuit.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallised to serve as earth. Earth connections are made by means of hollow rivets.

**OPERATING NOTE** Below 70 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





Conditions for R. F. SOAR:

$f = 175 \text{ MHz}$        $P_{Snom} = P_S$  at  $V_{CC} = V_{CCnom}$  and  $V.S.W.R. = 1$   
 $T_h = 70^\circ \text{C}$        $R_{th mb-h} = 0.6 \text{ K/W}$   
 $V_{CCnom} = 12.5 \text{ or } 13.5 \text{ V}$  see also page 5

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graphs above for safe operation at supply voltages other than the nominal. The graphs show the allowable output power under nominal conditions, as a function of the supply overvoltage ratio, with V. S. W. R. as parameter.

The left hand graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply overvoltage ratio.

The right hand graph shows the derating factor to be applied when the drive ( $P_S/P_{Snom}$ ) increases as the square of the supply overvoltage ratio ( $V_{CC}/V_{CCnom}$ ).

Depending on the operating conditions, the appropriate derating factor may lie in the region between the linear and the square-law functions.

## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile, h.f. and v.h.f. transmitters with a nominal supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

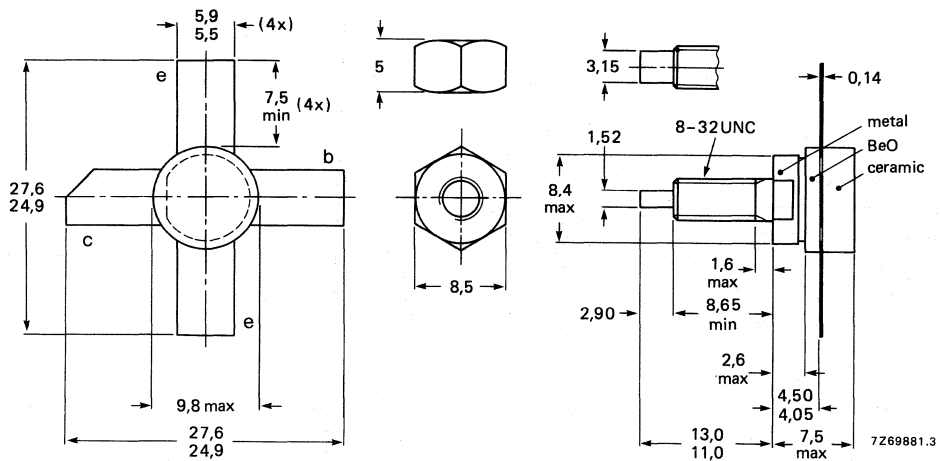
R.F. performance up to  $T_h = 25^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	8	> 12,0	> 60	$2,2 + j0,4$	$96 - j28$
c.w.	12,5	175	8	typ. 11,5	typ. 65	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ )

peak value

$V_{CESM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

$I_C(AV)$  max. 1,5 A

Collector current (peak value);  $f > 1$  MHz

$I_{CM}$  max. 4,0 A

R.F. power dissipation ( $f > 1$  MHz);  $T_{mb} = 25$  °C

$P_{rf}$  max. 20 W

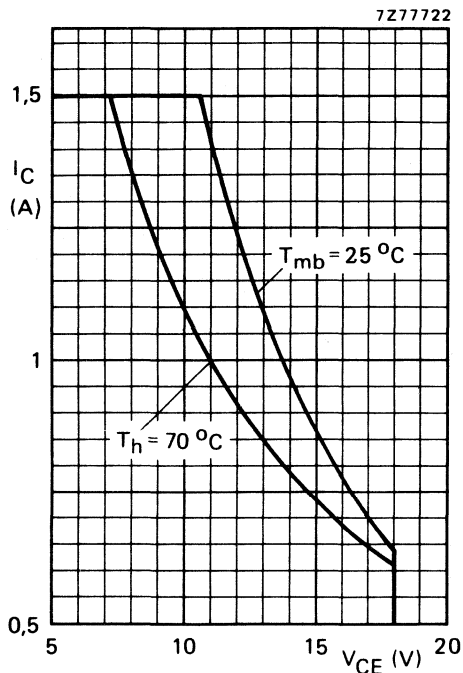


Fig. 2 D.C. SOAR.

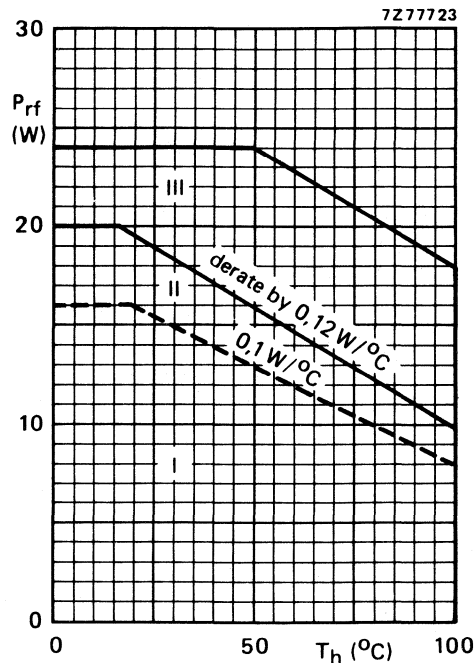


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

Storage temperature

$T_{stg}$  -65 to + 150 °C

Operating junction temperature

$T_j$  max. 200 °C

**THERMAL RESISTANCE** (dissipation = 8 W;  $T_{mb} = 73,5$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)

$R_{th j-mb(dc)}$  = 10,7 K/W

From junction to mounting base (r.f. dissipation)

$R_{th j-mb(rf)}$  = 8,6 K/W

From mounting base to heatsink

$R_{th mb-h}$  = 0,45 K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 5\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 25\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 1\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 2\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 0,5\text{ mJ}$  $R_{BE} = 10\ \Omega$  $E_{SBR} > 0,5\text{ mJ}$ 

D.C. current gain \*

 $I_C = 0,75\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 2\text{ A}; I_B = 0,4\text{ A}$  $V_{CEsat}$  typ. 0,85 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 0,75\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 950 MHz $-I_E = 2\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 850 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 13,5\text{ V}$  $C_c$  typ. 16,5 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 13,5\text{ V}$  $C_{re}$  typ. 12 pF

Collector-stud capacitance

 $C_{cs}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}; \delta \leq 0,02$ .

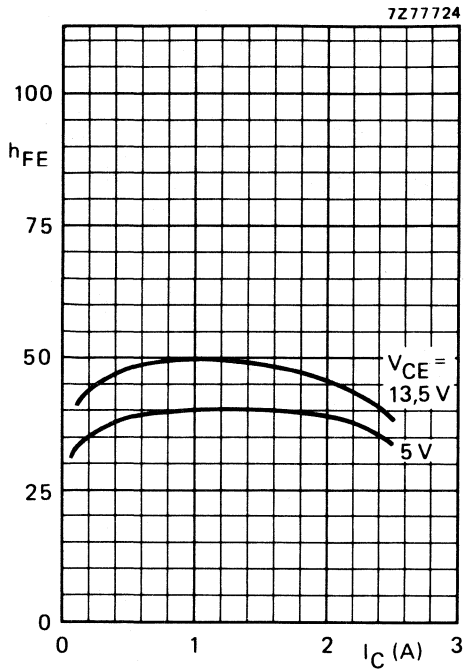


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

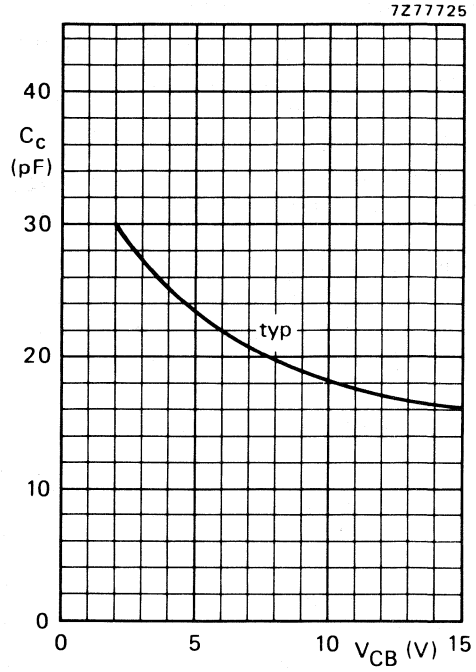


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

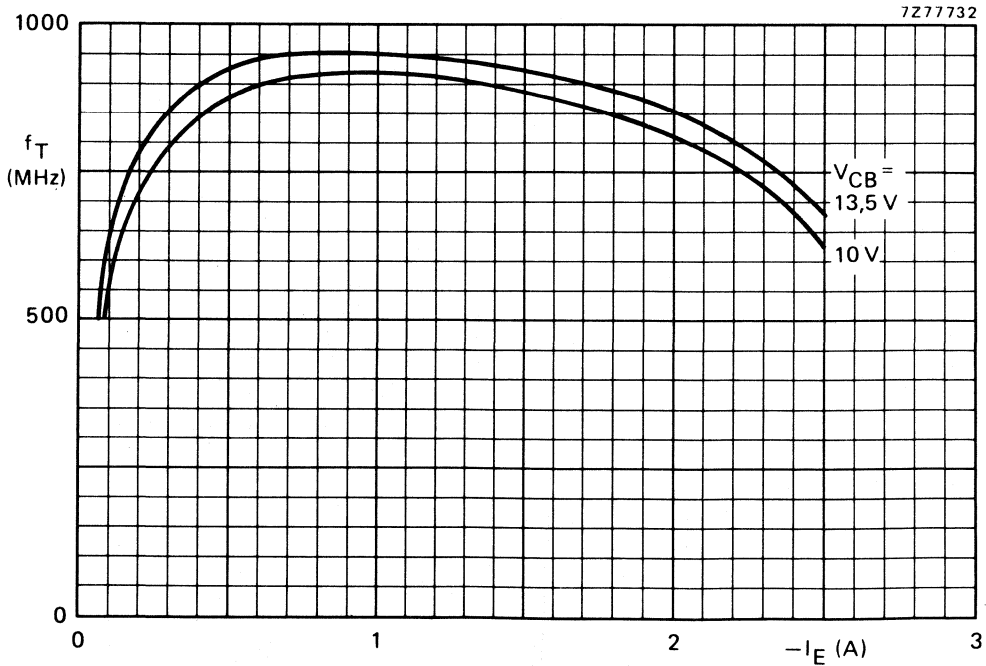


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{V}_L$ (mS)
175	13,5	8	< 0,5	> 12,0	< 0,99	> 60	2,2 + j0,4	96 - j28
175	12,5	8	—	typ. 11,5	—	typ. 65	—	—

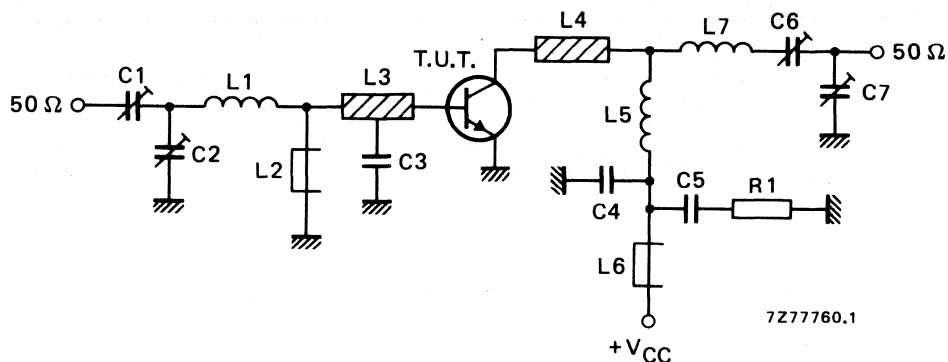


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 2 turns Cu wire (1,6 mm); int. dia. 4,5 mm; length 5,7 mm; leads 2 x 5 mm

L2 = L6 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L4 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

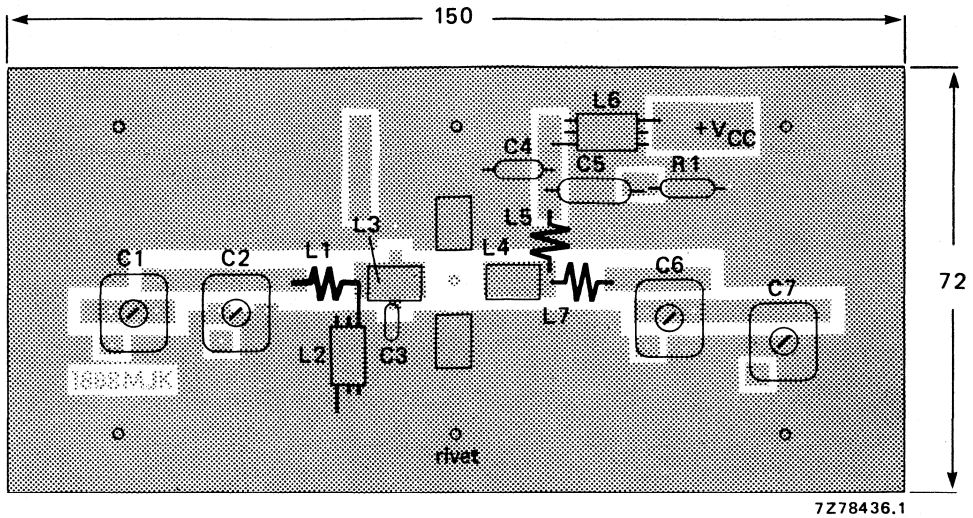
L5 = 3 turns Cu wire (1,6 mm); int. dia. 7,5 mm; length 7,5 mm; leads 2 x 5 mm

L7 = 3 turns Cu wire (1,6 mm); int. dia. 6,5 mm; length 7,4 mm; leads 2 x 5 mm

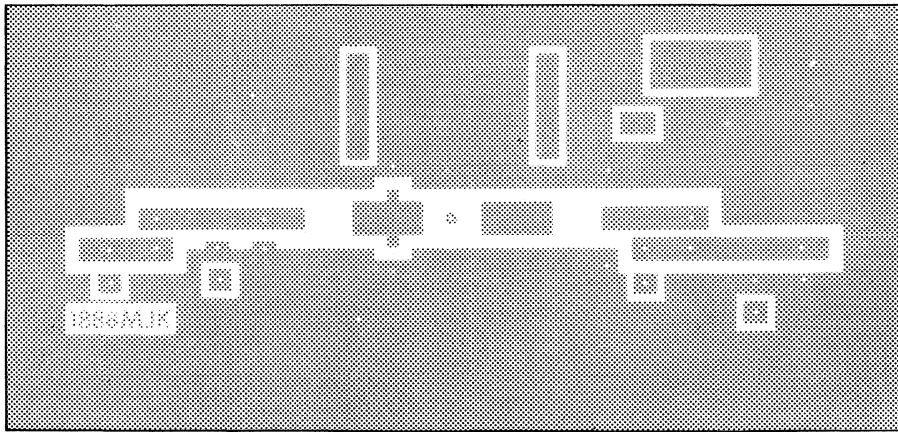
L3 and L4 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.



7Z78436.1



7Z78437

Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

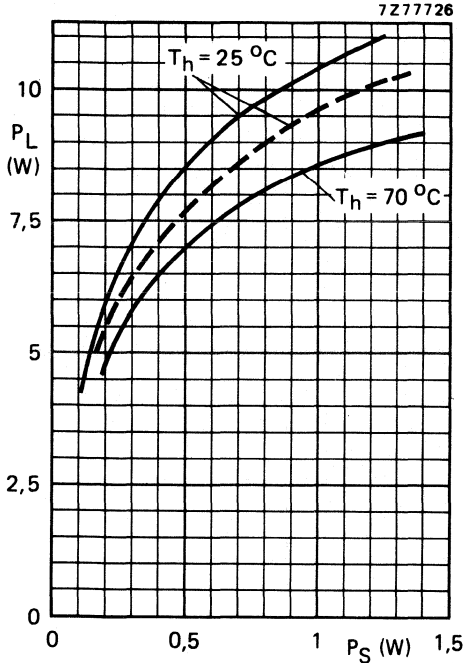


Fig. 9 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 13,5 \text{ V}$ ; - - -  $V_{CE} = 12,5 \text{ V}$ .

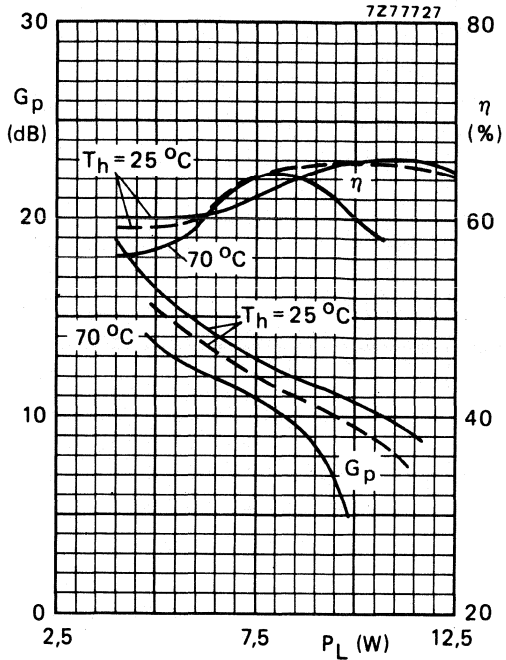


Fig. 10 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 13,5 \text{ V}$ ; - - -  $V_{CE} = 12,5 \text{ V}$ .

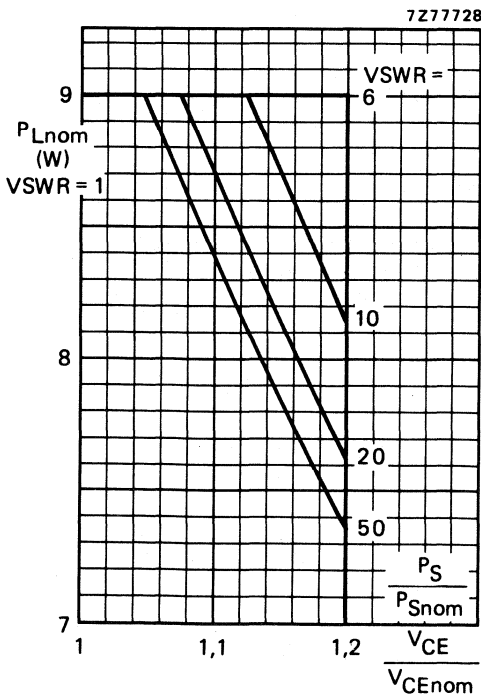


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  
 $R_{th \text{ mb-h}} = 0,45 \text{ K/W}$ ;  $V_{CEnom} = 13,5 \text{ V}$  or  $12,5 \text{ V}$ ;  $P_S = P_{Snom}$  at  $V_{CEnom}$  and  $VSWR = 1$ .

Note to Fig. 11:

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ), as a function of the expected supply over-voltage ratio with  $VSWR$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

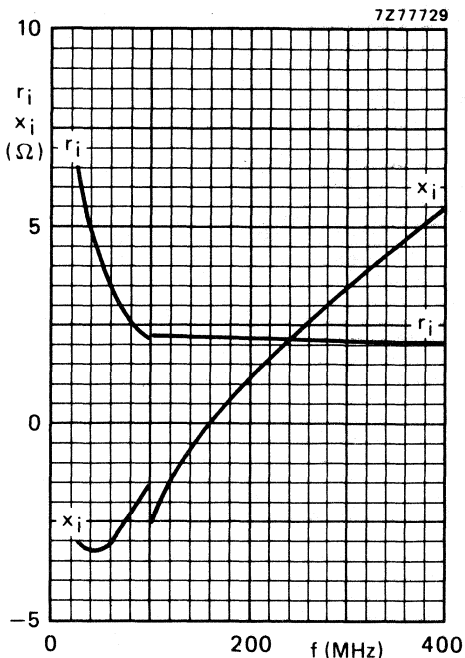


Fig. 12 Input impedance (series components).

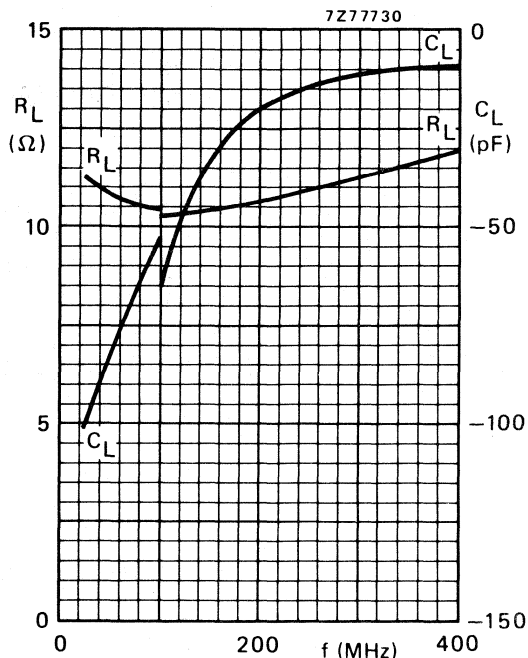


Fig. 13 Load impedance (parallel components).

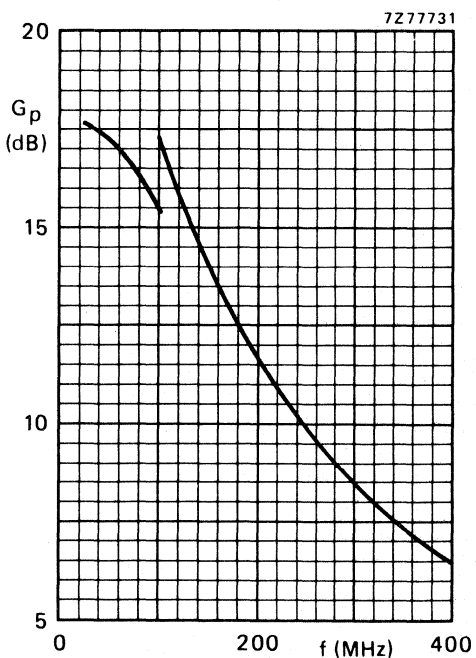


Fig. 14.

Conditions for Figs 12, 13 and 14:  
 Typical values;  $V_{CE} = 13,5 \text{ V}$ ;  $P_L = 8 \text{ W}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ .

**OPERATING NOTE**

Below 100 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation.  
 This resistor must be effective for r.f. only.

## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in class-A, B and C operated mobile and military transmitters with a supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a  $\frac{1}{4}$ " capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

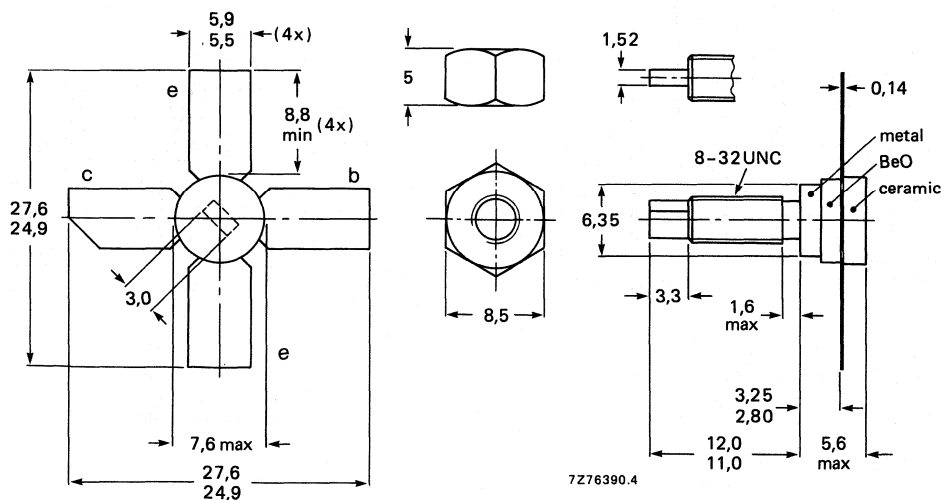
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	8	> 9	> 70	$2,8 + j1,2$	$76 - j16$
c.w.	12,5	175	8	typ. 9	typ. 70	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)  
peak value

$V_{CBOM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

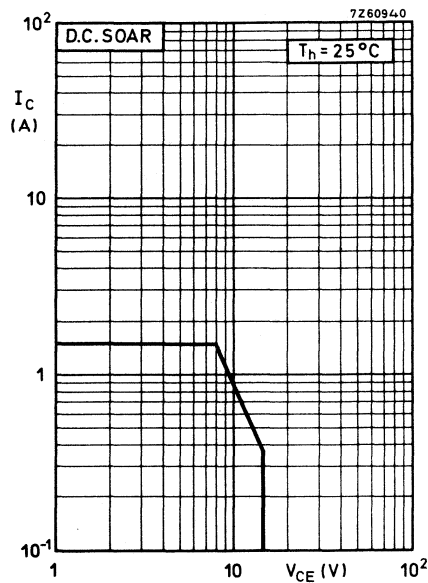
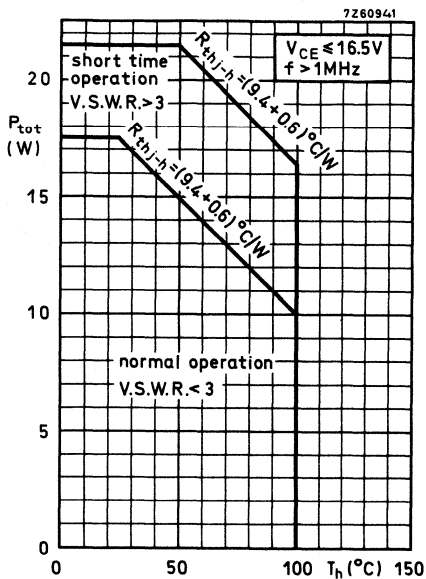
$I_{C(AV)}$  max. 1.25 A

Collector current (peak value)  $f > 1$  MHz

$I_{CM}$  max. 3.75 A

Total power dissipation up to  $T_h = 25^\circ\text{C}$   
 $f > 1$  MHz

$P_{tot}$  max. 17.5 W



Storage temperature

$T_{stg}$  -30 to +200  $^\circ\text{C}$

Operating junction temperature

$T_j$  max. 200  $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to mounting base

$R_{th j-mb} = 9.4 \text{ K/W}$

From mounting base to heatsink

$R_{th mb-h} = 0.6 \text{ K/W}$



## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_B = 0; V_{CE} = 14\text{ V}$   $I_{CEO} < 5\text{ mA}$

Breakdown voltages

Collector-base voltage  
open emitter,  $I_C = 1\text{ mA}$

$V_{(BR)CBO} > 36\text{ V}$

Collector-emitter voltage  
open base,  $I_C = 10\text{ mA}$

$V_{(BR)CEO} > 18\text{ V}$

Emitter-base voltage  
open collector,  $I_E = 1\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

Transient energy

$L = 25\text{ mH}; f = 50\text{ Hz}$

open base

$E > 0.5\text{ mS}$

$-V_{BE} = 1.5\text{ V}; R_{BE} = 33\ \Omega$

$E > 0.5\text{ mS}$

D.C. current gain

$I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$

$h_{FE} > 5$

Transition frequency

$I_C = 500\text{ mA}; V_{CE} = 10\text{ V}$

$f_T$  typ. 700 MHz

Collector capacitance at  $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 15\text{ V}$

$C_c$  typ. 15 pF  
< 20 pF

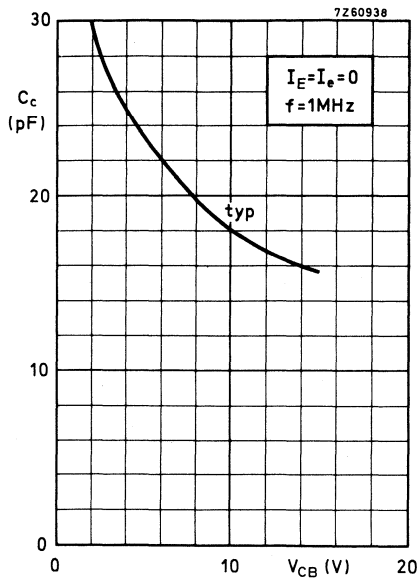
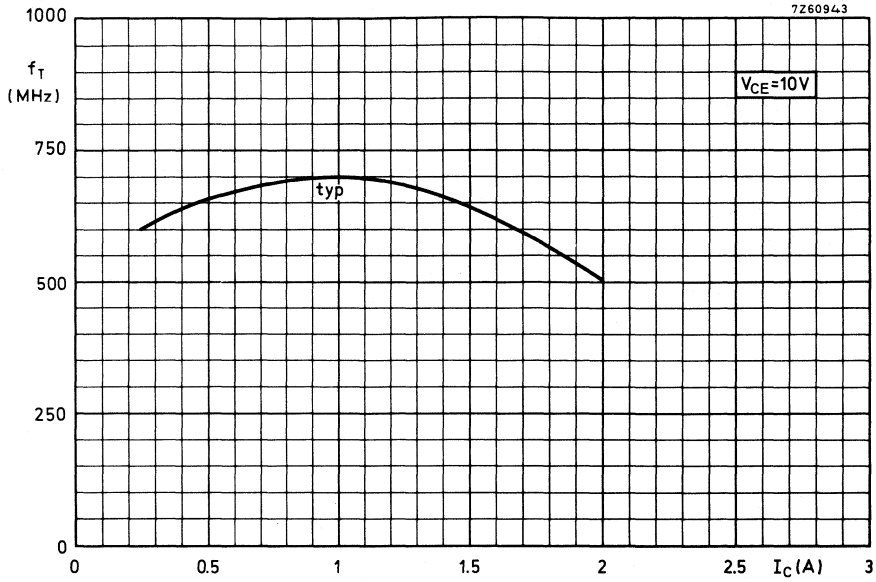
Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 100\text{ mA}; V_{CE} = 15\text{ V}$

$-C_{re}$  typ. 11 pF

Collector-stud capacitance

$C_{cs}$  typ. 2 pF



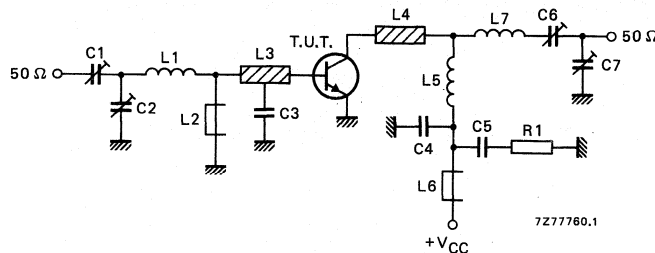
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

$f = 175 \text{ MHz}$ ;  $T_{mb}$  up to  $25^\circ\text{C}$

$V_{CC}(\text{V})$	$P_S(\text{W})$	$P_L(\text{W})$	$I_C(\text{A})$	$G_p(\text{dB})$	$\eta(\%)$	$Z_i(\Omega)$	$\bar{Y}_L(\text{mS})$
13.5	< 1.0	8	< 0.85	> 9	> 70	$2.8 + j1.2$	$76 - j16$
12.5	typ. 1.0	8	typ. 0.91	typ. 9	typ. 70	—	—

Test circuit



List of components:

C1 = 2.5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 2 turns Cu wire (1.6 mm); int. dia. 4.5 mm; length 5.7 mm; leads 2 x 5 mm

L2 = L6 = Ferroxcube wide-band h. f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L4 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

L5 = 3 turns Cu wire (1.6 mm); int. dia. 7.5 mm; length 7.5 mm; leads 2 x 5 mm

L7 = 3 turns Cu wire (1.6 mm); int. dia. 6.5 mm; length 7.4 mm; leads 2 x 5 mm

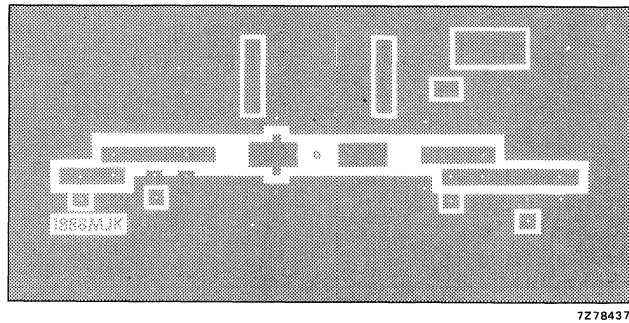
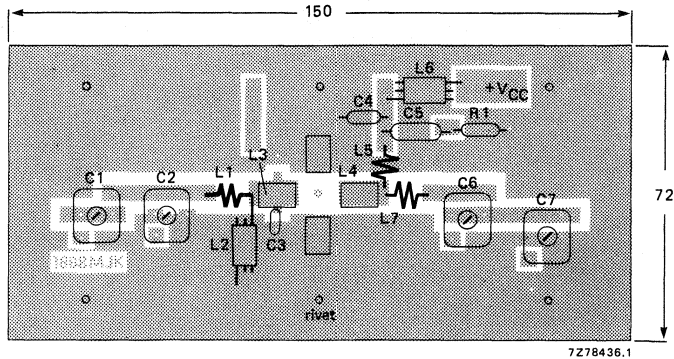
L3 and L4 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see following page.

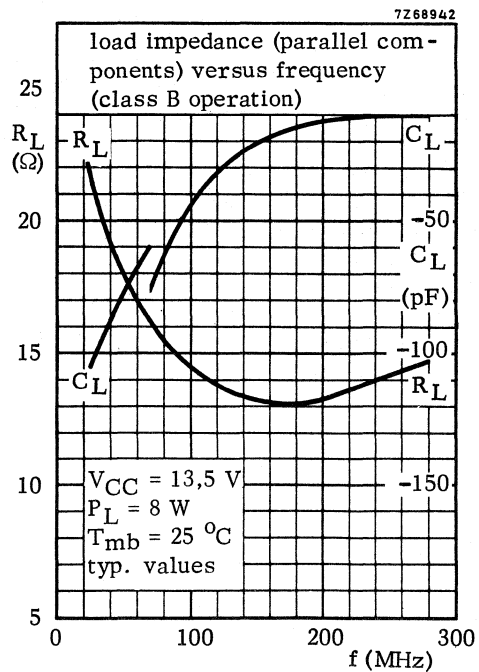
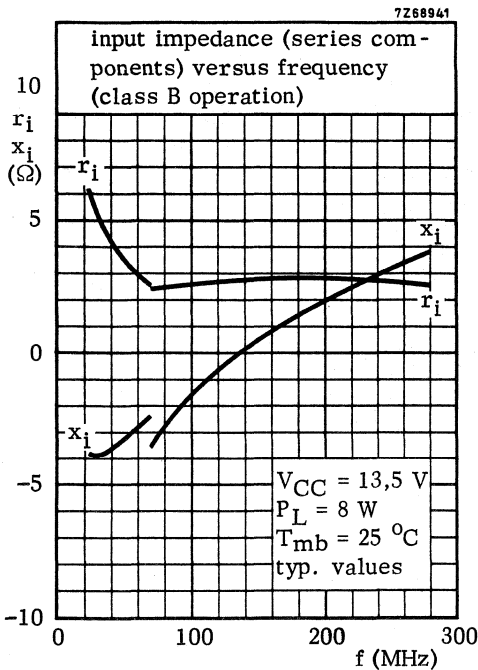
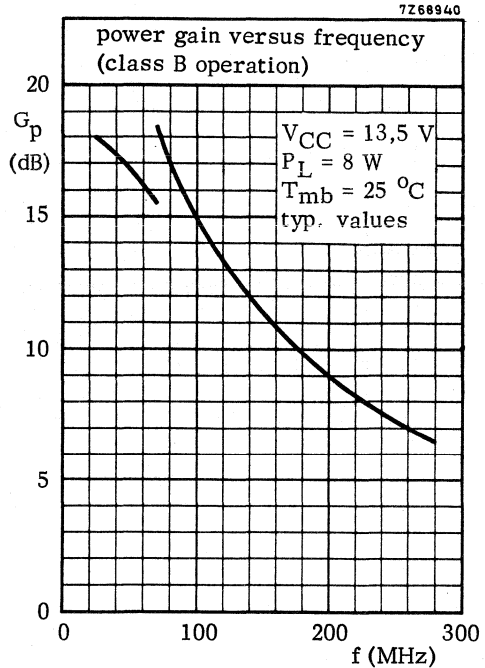
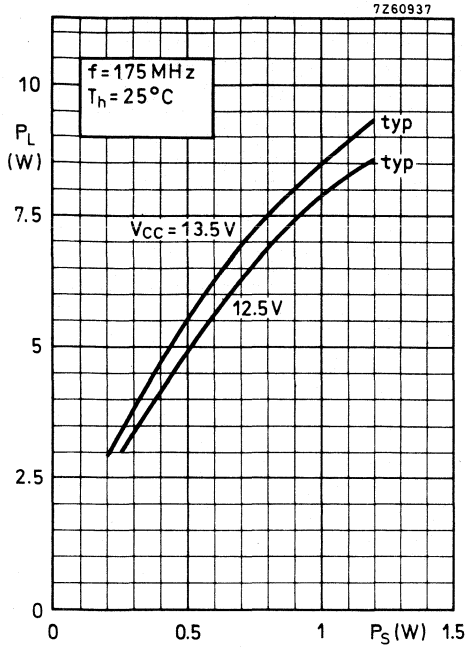
**APPLICATION INFORMATION** (continued)

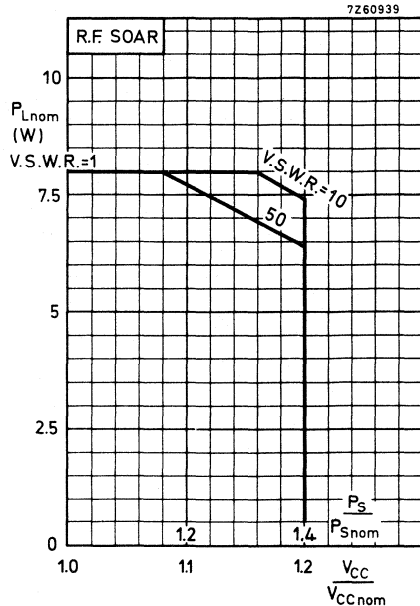
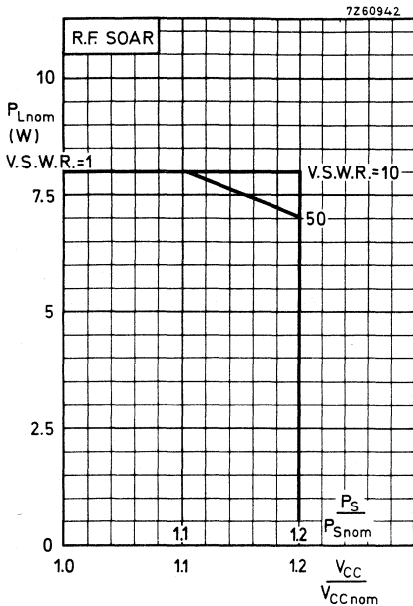
Component layout and printed circuit board for 175 MHz test circuit.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

**OPERATING NOTE** Below 70 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





Conditions for R.F. SOAR:

$f = 175 \text{ MHz}$        $P_{Snom} = P_S \text{ at } V_{CC} = V_{CCnom} \text{ and } V.S.W.R. = 1$   
 $T_h = 70 \text{ }^\circ\text{C}$        $R_{th mb-h} = 0.6 \text{ K/W}$   
 $V_{CCnom} = 12.5 \text{ or } 13.5 \text{ V}$  see also page 5

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graphs above for safe operation at supply voltages other than the nominal. The graphs show the allowable output power under nominal conditions, as a function of the supply overvoltage ratio, with V.S.W.R. as parameter.

The left hand graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply overvoltage ratio.

The right hand graph shows the derating factor to be applied when the drive ( $P_S/P_{Snom}$ ) increases as the square of the supply overvoltage ratio ( $V_{CC}/V_{CCnom}$ ).

Depending on the operating conditions, the appropriate derating factor may lie in the region between the linear and the square-law functions.

### V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 1/4" capstan envelope with a moulded cap. All leads are isolated from the stud.

#### QUICK REFERENCE DATA

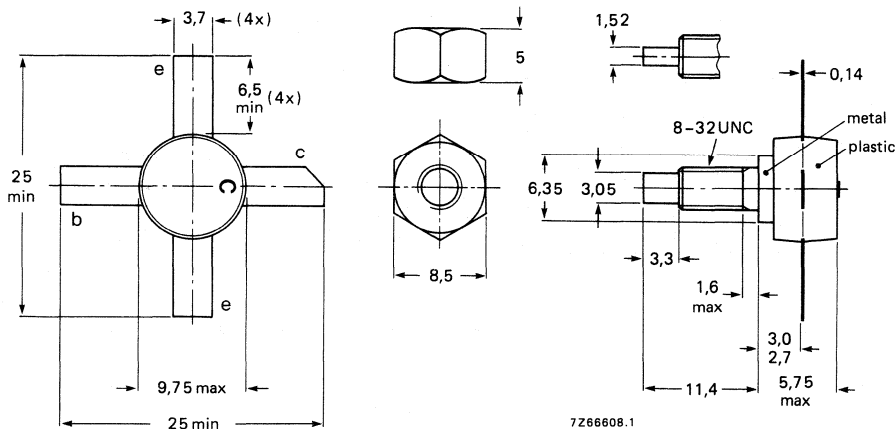
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	15	> 7,5	> 65	2,3 + j2,2	128 - j4,4
c.w.	12,5	175	15	typ. 7,5	typ. 65	-	-

#### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/2.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

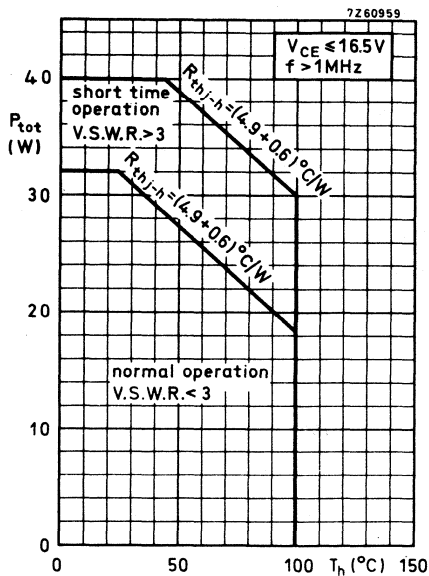
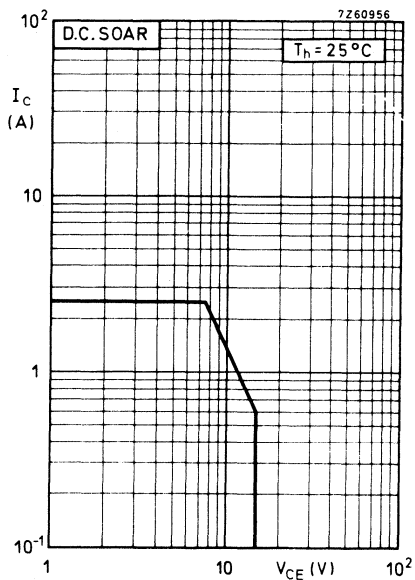
Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or  
countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134).

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4	V
Collector current (average)	$I_C(AV)$	max.	2.5	A
Collector (peak value) $f > 1$ MHz	$I_{CM}$	max.	7.5	A
Total power dissipation up to $T_h = 25$ °C $f > 1$ MHz	$P_{tot}$	max.	32	W



Storage temperature	$T_{stg}$	-30 to +200	°C
Operating junction temperature	$T_j$	max. 200	°C

**THERMAL RESISTANCE**

From junction to mounting base	$R_{th\ j-mb}$	=	4.9	K/W
From mounting base to heatsink	$R_{mb-h}$	=	0.6	K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

 $I_B = 0; V_{CE} = 14\text{ V}$   $I_{CEO} < 10\text{ mA}$ 

Breakdown voltages

Collector-base voltage

open emitter,  $I_C = 3\text{ mA}$   $V_{(BR)CBO} > 36\text{ V}$ 

Collector-emitter voltage

open base,  $I_C = 25\text{ mA}$   $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base voltage

open collector;  $I_E = 3\text{ mA}$   $V_{(BR)EBO} > 4\text{ V}$ 

Transient energy

 $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $-V_{BE} = 1.5\text{ V}; R_{BE} = 33\text{ }\Omega$   $E > 2.0\text{ ms}$  $E > 4.5\text{ ms}$ 

D. C. current gain

 $I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$   $h_{FE} > 5$ 

Transition frequency

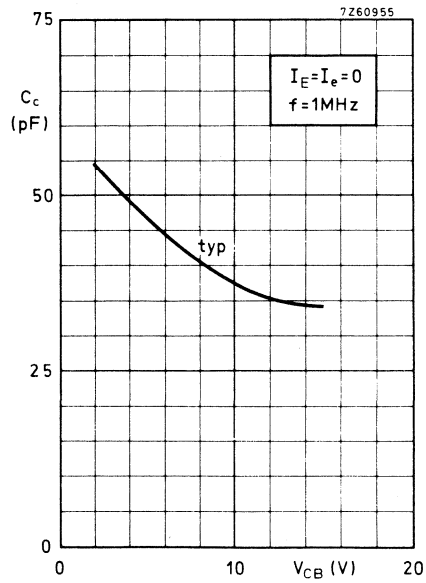
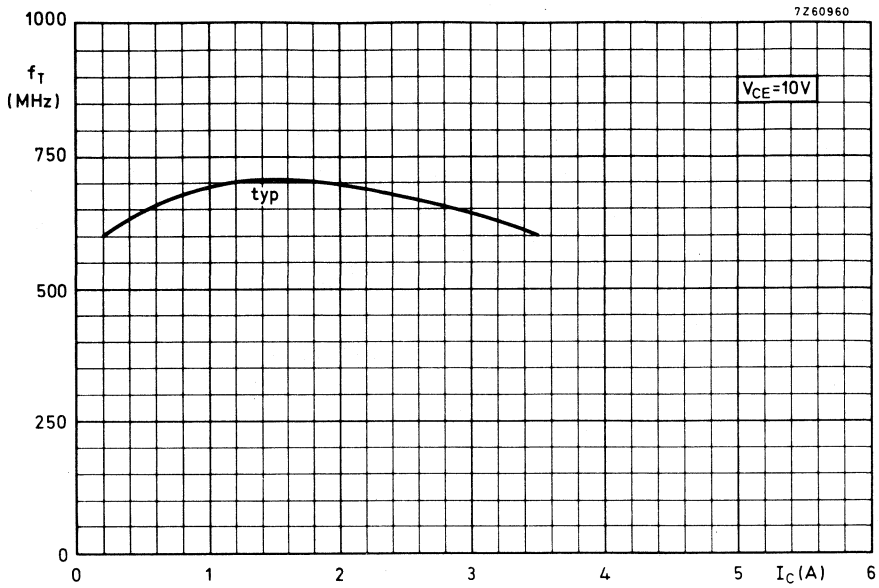
 $I_C = 1\text{ A}; V_{CE} = 10\text{ V}$   $f_T$  typ. 700 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 15\text{ V}$   $C_c$  typ. 34 pF

&lt; 40 pF

Feedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 15\text{ V}$   $-C_{re}$  typ. 25 pF

Collector-stud capacitance

 $C_{cs}$  typ. 2 pF



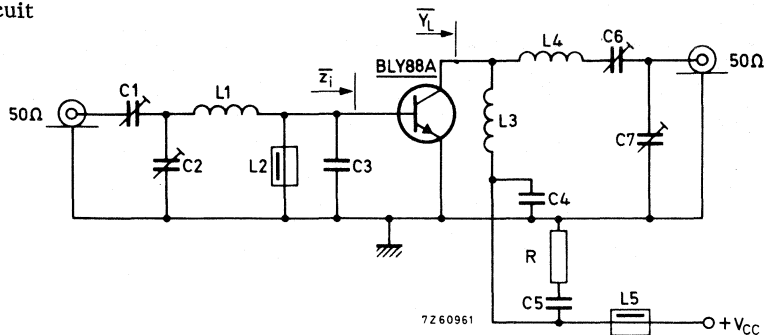
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

 $f = 175 \text{ MHz}$ ;  $T_{mb}$  up to  $25^\circ\text{C}$ 

$V_{CC}(\text{V})$	$P_S(\text{W})$	$P_L(\text{W})$	$I_C(\text{A})$	$G_p(\text{dB})$	$\eta(\%)$	$\bar{z}_i(\Omega)$	$\bar{Y}_L(\text{mS})$
13.5	< 2.65	15	< 1.71	> 7.5	> 65	$2.3 + j2.2$	$128 - j4.4$
12.5	typ. 2.65	15	typ. 1.85	typ. 7.5	typ. 65	—	—

Test circuit



C1= 2.5 to 20 pF film dielectric trimmer (code number 2222 809 07004)

C2=C6=C7= 4 to 40 pF film dielectric trimmer (code number 2222 809 07008)

C3= 47 pF ceramic

C4= 100 pF ceramic

C5= 150 nF polyester

L1= 0.5 turn enamelled Cu wire (1.5 mm); int. diam. 6 mm; leads 2 x 10 mm

L2=L5= ferroxcube choke (code number 4312 020 36640)

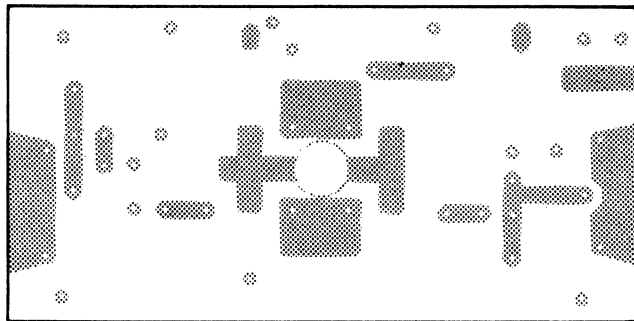
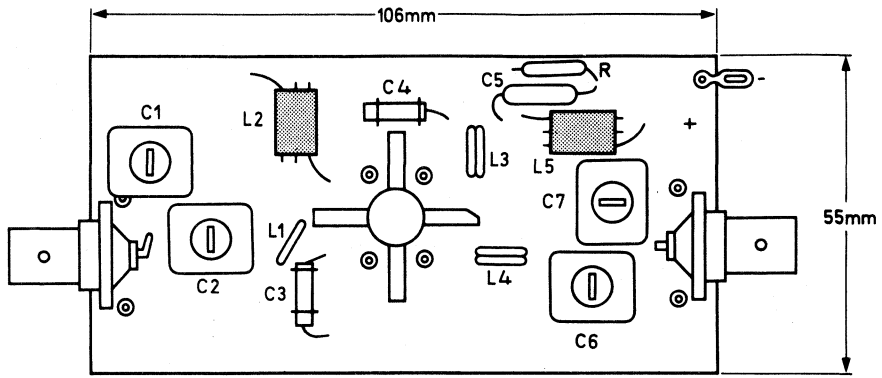
L3= 2.5 turns closely wound enamelled Cu wire (1.5 mm); int. diam. 6 mm; leads 2 x 10 mm

L4= 2.5 turns enamelled Cu wire (1.5 mm); int. diam. 6 mm; leads 2 x 10 mm

R = 10Ω carbon

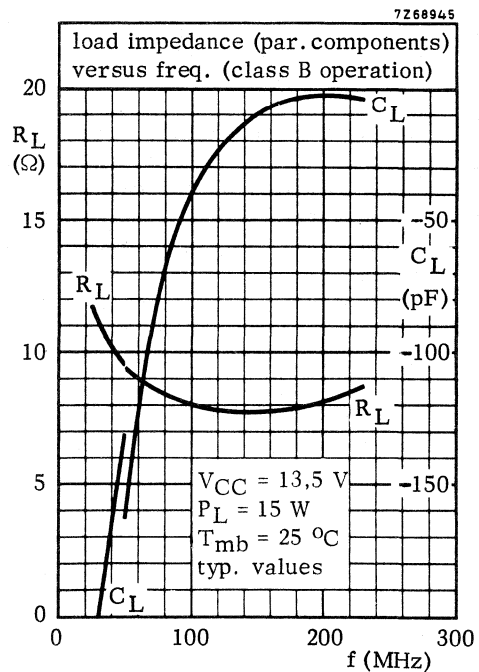
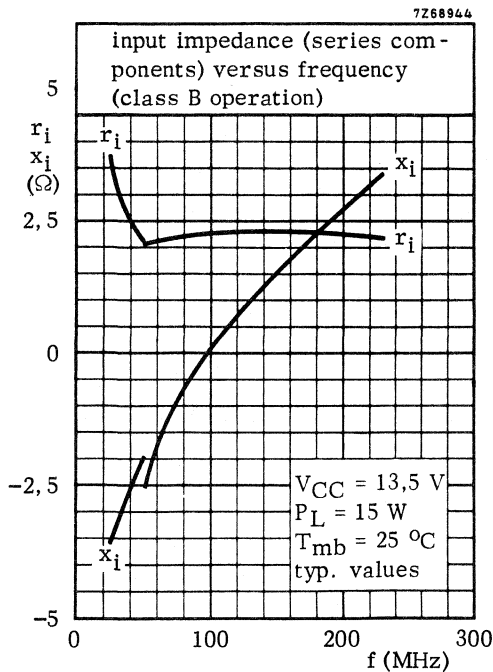
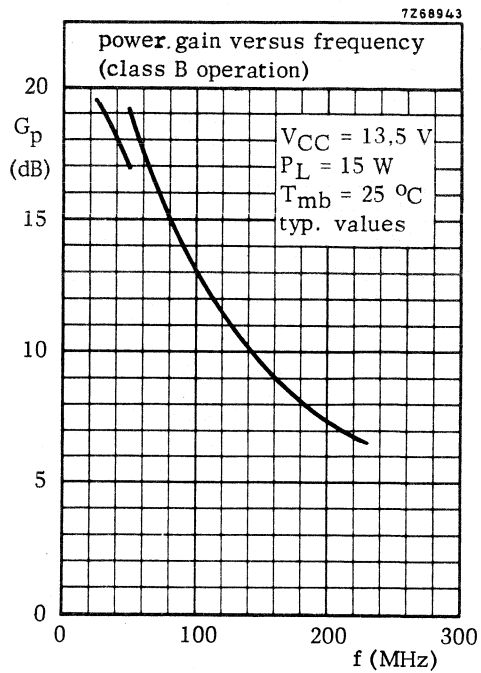
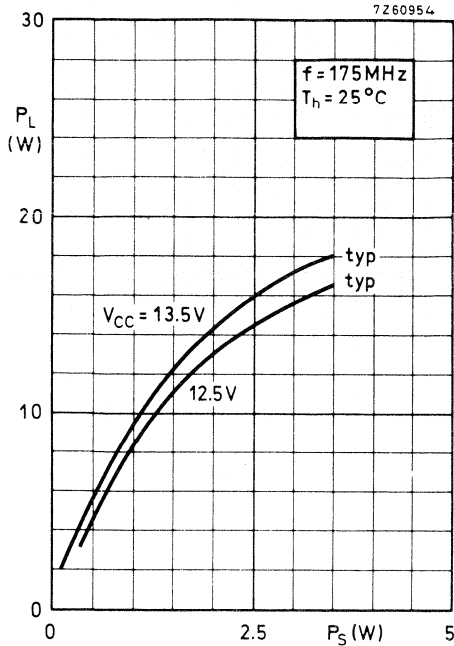
**APPLICATION INFORMATION** (continued)

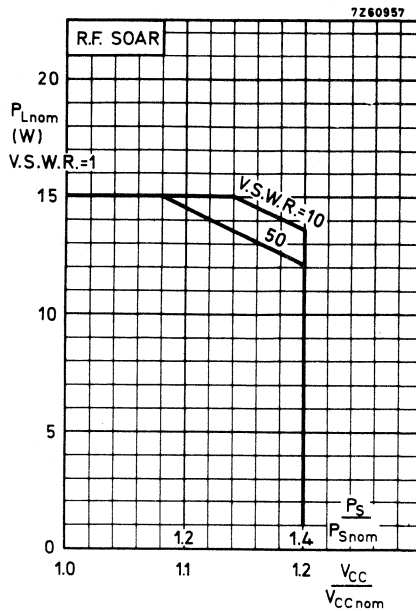
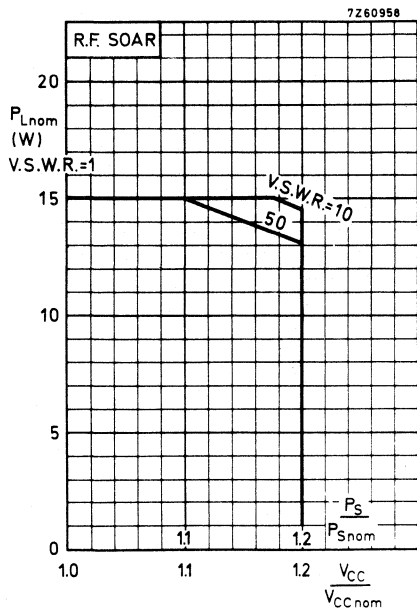
Component lay-out and printed circuit board for 175 MHz test circuit.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallised to serve as earth. Earth connections are made by means of hollow rivets.

**OPERATING NOTE** Below 50 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





Conditions for R.F. SOAR:

$f = 175 \text{ MHz}$        $P_{Snom} = P_S \text{ at } V_{CC} = V_{CCnom} \text{ and } V.S.W.R. = 1$   
 $T_h = 70 \text{ }^\circ\text{C}$        $R_{th \text{ mb-h}} = 0.6 \text{ K/W}$   
 $V_{CCnom} = 12.5 \text{ or } 13.5 \text{ V}$  see also page 5

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graphs above for safe operation at supply voltages other than the nominal. The graphs show the allowable output power under nominal conditions, as a function of the supply overvoltage ratio, with V. S. W. R. as parameter.

The left hand graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply overvoltage ratio.

The right hand graph shows the derating factor to be applied when the drive ( $P_S/P_{Snom}$ ) increases as the square of the supply overvoltage ratio ( $V_{CC}/V_{CCnom}$ ).

Depending on the operating conditions, the appropriate derating factor may lie in the region between the linear and the square-law functions.

## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile, h.f. and v.h.f. transmitters with a nominal supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

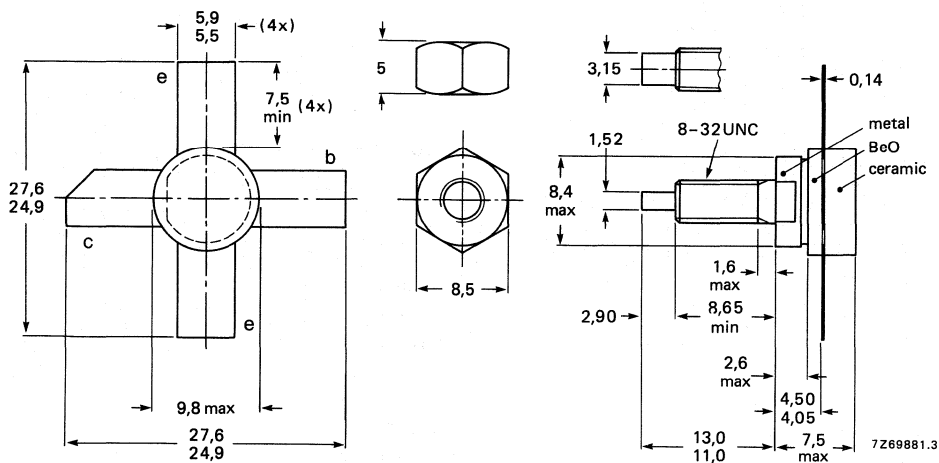
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	15	> 8,0	> 60	2,3 + j2,2	130 - j4,4
c.w.	12,5	175	15	typ. 7,5	typ. 67	-	-

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$ max.	36 V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	18 V
Emitter-base voltage (open collector)	$V_{EBO}$ max.	4 V
Collector current (average)	$I_{C(AV)}$ max.	3 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$ max.	8 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$ max.	36 W
Storage temperature	$T_{stg}$	-65 to +150 °C
Operating junction temperature	$T_j$ max.	200 °C

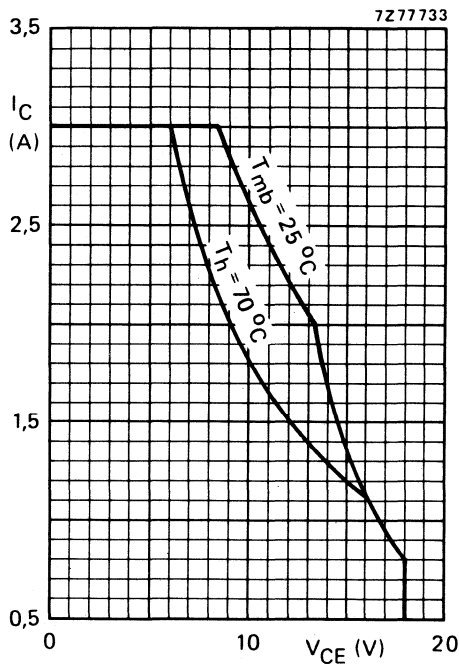


Fig. 2 D.C. SOAR.

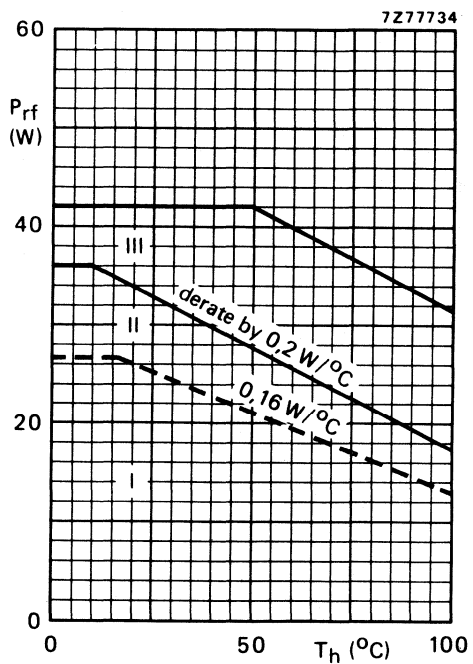


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 16,5$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 15 W;  $T_{mb} = 77$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th j-mb(dc)}$	= 6,55 K/W
From junction to mounting base (r.f. dissipation)	$R_{th j-mb(rf)}$	= 4,95 K/W
From mounting base to heatsink	$R_{th mb-h}$	= 0,45 K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 4\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 4\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\ \Omega$  $ESBO > 2,5\text{ mJ}$  $ESBR > 2,5\text{ mJ}$ 

D.C. current gain\*

 $I_C = 1,5\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 40  
10 to 100

Collector-emitter saturation voltage\*

 $I_C = 4,5\text{ A}; I_B = 0,9\text{ A}$  $V_{CEsat}$  typ. 1,0 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 1,5\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 850 MHz $-I_E = 4,5\text{ A}; V_{CB} = 13,5\text{ V}$  $f_T$  typ. 800 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 13,5\text{ V}$  $C_c$  typ. 32 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 200\text{ mA}; V_{CE} = 13,5\text{ V}$  $C_{re}$  typ. 23 pF

Collector-stud capacitance

 $C_{cs}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\ \mu\text{s}; \delta \leq 0,02$ .

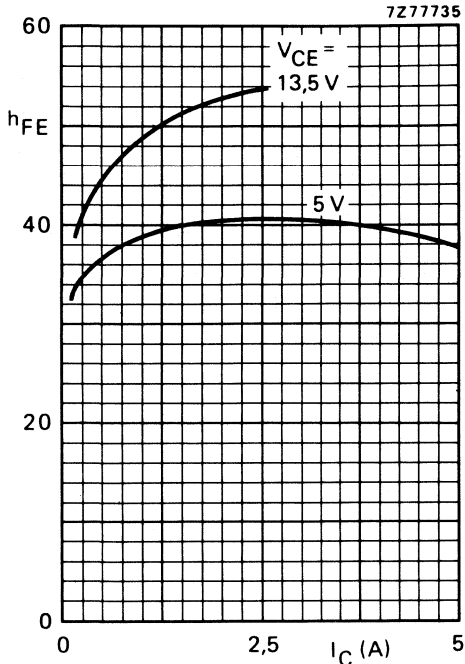


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

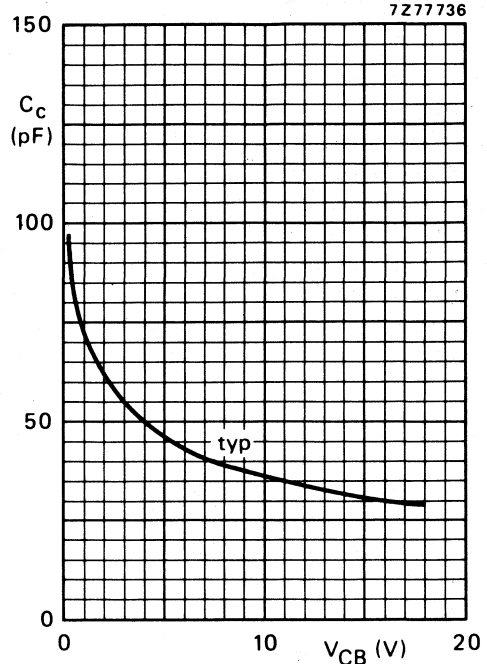


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

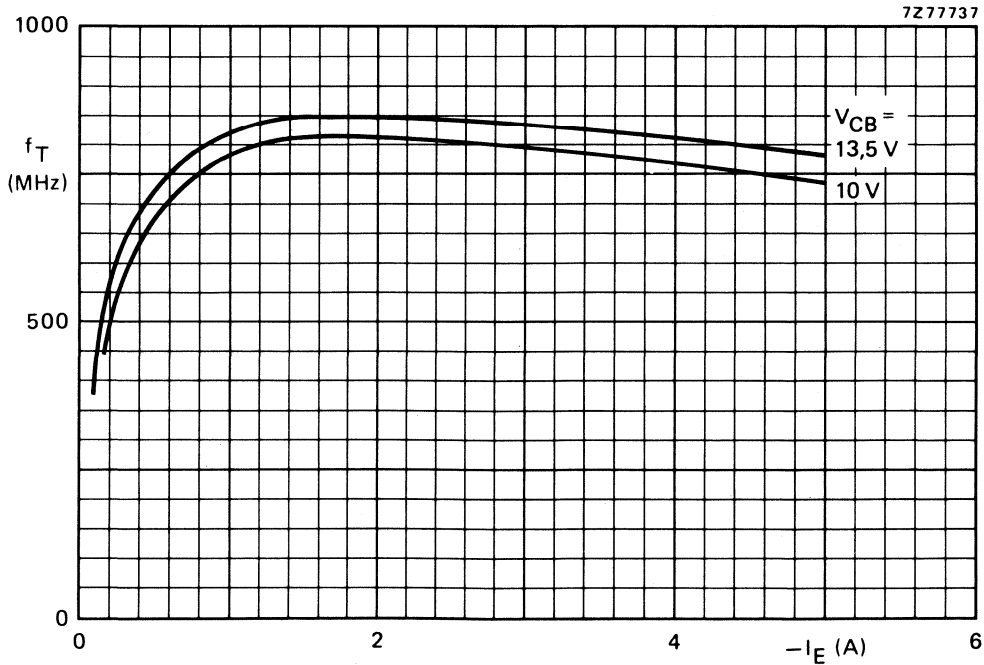


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	13,5	15	< 2,4	> 8,0	< 1,85	> 60	2,3 + j2,2	130 - j4,4
175	12,5	15	-	typ. 7,5	-	typ. 67	-	-

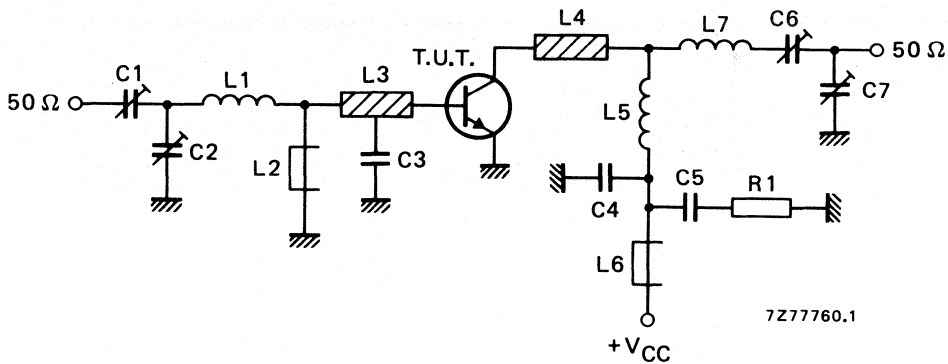


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 2 turns Cu wire (1,6 mm); int. dia. 4,5 mm; length 5,7 mm; leads 2 x 5 mm

L2 = L6 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L4 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

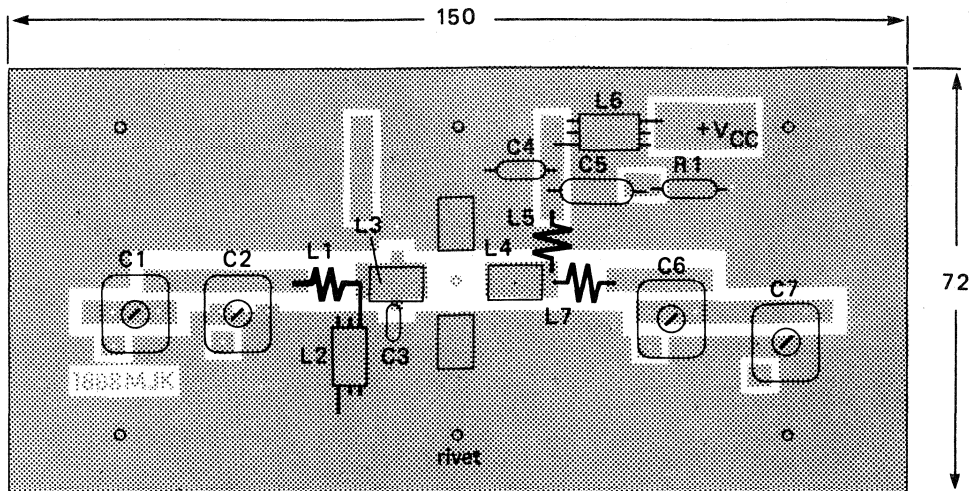
L5 = 3 turns Cu wire (1,6 mm); int. dia. 7,5 mm; length 7,5 mm; leads 2 x 5 mm

L7 = 3 turns Cu wire (1,6 mm); int. dia. 6,5 mm; length 7,4 mm; leads 2 x 5 mm

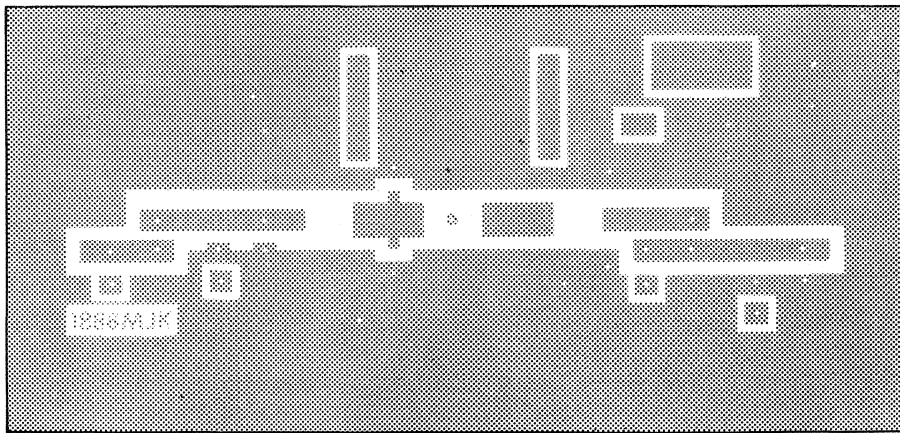
L3 and L4 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.



7278436.1



7278437

Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

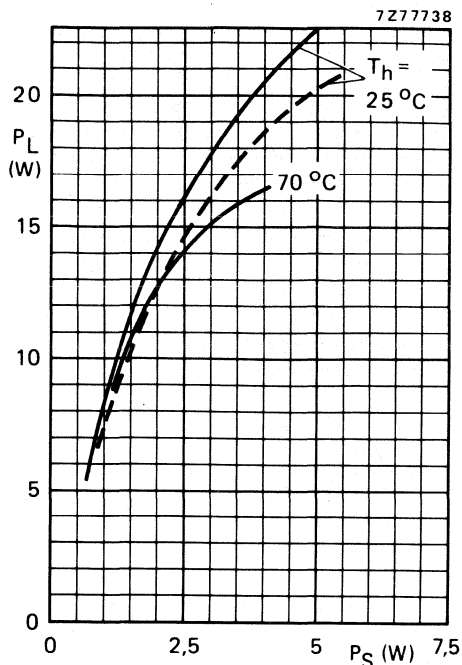


Fig. 9 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 13,5 \text{ V}$ ; - - -  $V_{CE} = 12,5 \text{ V}$ .

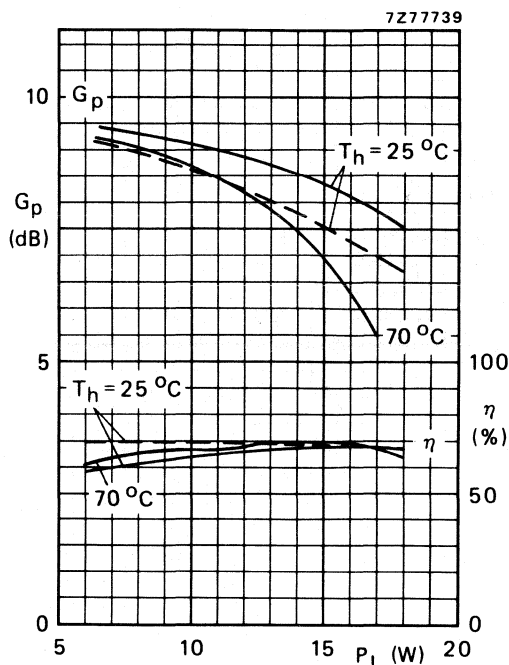


Fig. 10 Typical values;  $f = 175 \text{ MHz}$ ;  
 —  $V_{CE} = 13,5 \text{ V}$ ; - - -  $V_{CE} = 12,5 \text{ V}$ .

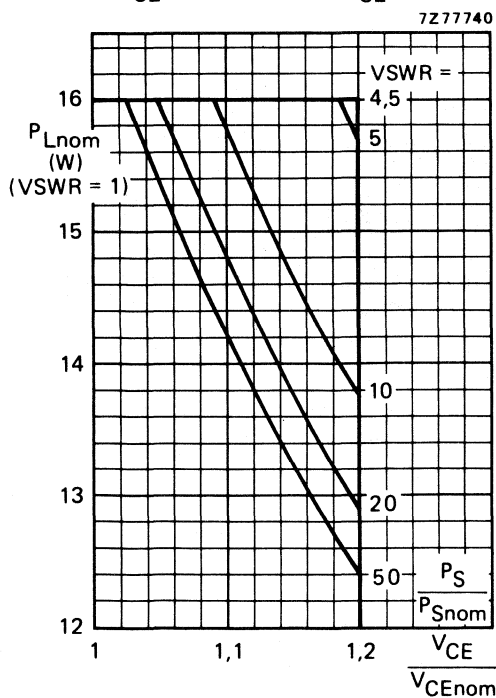


Fig. 11 R.F. SOAR (short-time operation during mismatch);  $f = 175 \text{ MHz}$ ;  $T_h = 70 \text{ }^\circ\text{C}$ ;  
 $R_{th \text{ mb-h}} = 0,45 \text{ K/W}$ ;  $V_{CE \text{ nom}} = 13,5 \text{ V}$  or  $12,5 \text{ V}$ ;  $P_S = P_{S \text{ nom}}$  at  $V_{CE \text{ nom}}$  and  $V_{SWR} = 1$ .

Note to Fig. 11:

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $V_{SWR} = 1$ ), as a function of the expected supply over-voltage ratio with  $V_{SWR}$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{S \text{ nom}}$ ) increases linearly with supply over-voltage ratio.

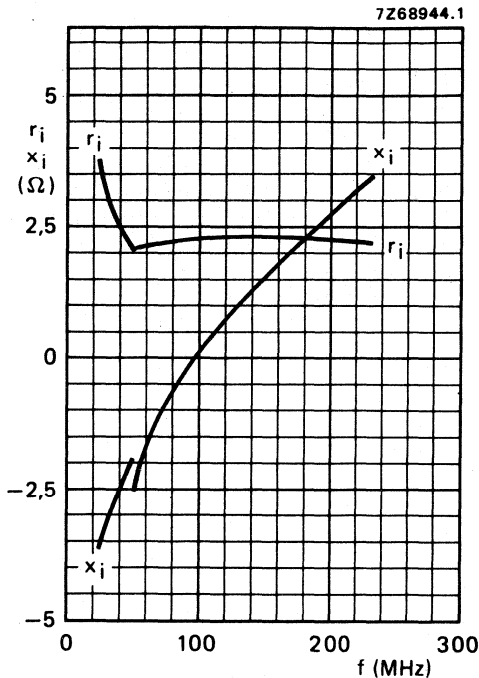


Fig. 12 Input impedance (series components).

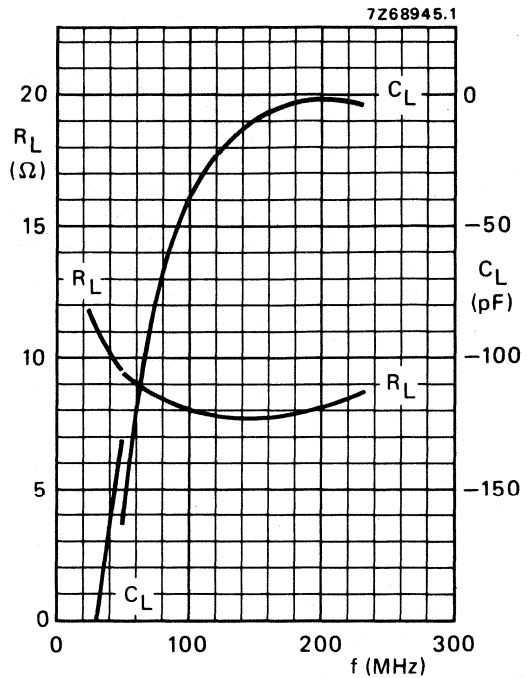


Fig. 13 Load impedance (parallel components).

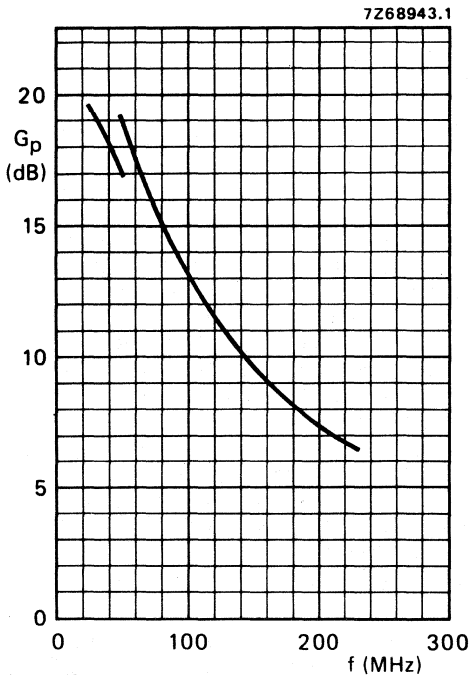


Fig. 14.

Conditions for Figs 12, 13 and 14:

Typical values:  $V_{CE} = 13.5 \text{ V}$ ;  $P_L = 15 \text{ W}$ ;  
 $T_h = 25 \text{ }^\circ\text{C}$ .

**OPERATING NOTE**

Below 50 MHz a base-emitter resistor of  $10 \Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V.

It has a 1/4" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

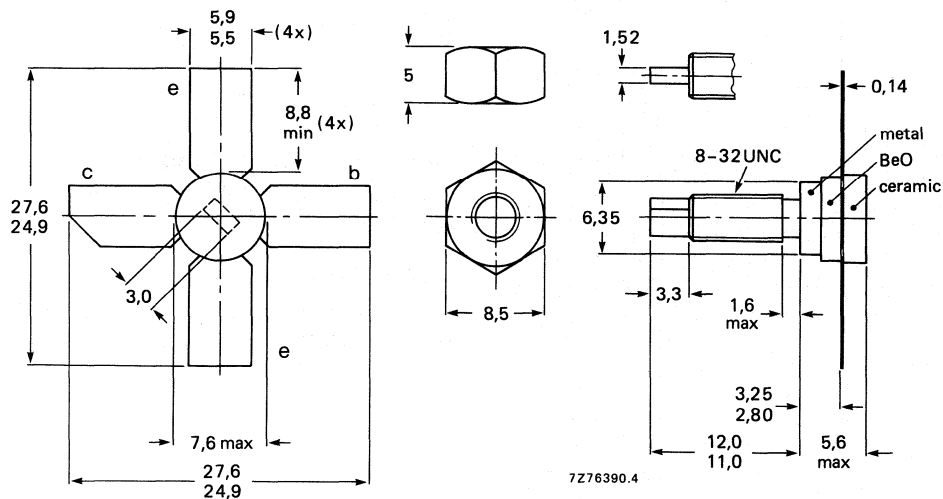
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	15	> 7,5	> 65	2,3 + j2,2	128 - j4,4
c.w.	12,5	175	15	typ. 7,5	typ. 65	—	—

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT122.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)  
peak value

$V_{CBOM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

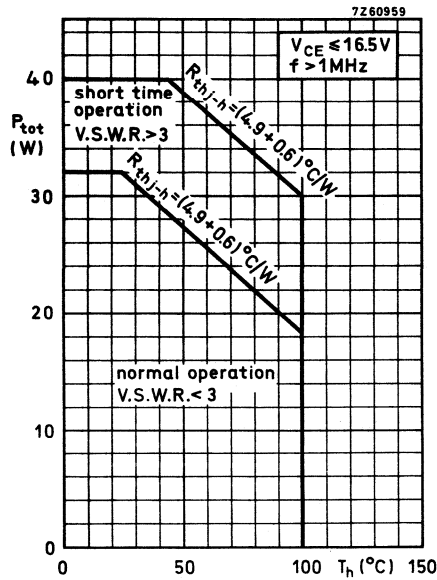
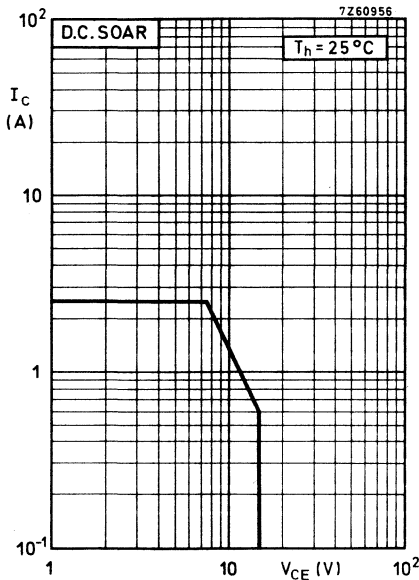
$I_C(AV)$  max. 2.5 A

Collector (peak value)  $f > 1$  MHz

$I_{CM}$  max. 7.5 A

Total power dissipation up to  $T_h = 25$  °C  
 $f > 1$  MHz

$P_{tot}$  max. 32 W



Storage temperature

$T_{stg}$  -30 to +200 °C

Operating junction temperature

$T_j$  max. 200 °C

**THERMAL RESISTANCE**

From junction to mounting base

$R_{th\ j-mb} = 4.9$  K/W

From mounting base to heatsink

$R_{mb-h} = 0.6$  K/W



## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_B = 0; V_{CE} = 14\text{ V} \quad I_{CEO} < 10\text{ mA}$$

Breakdown voltages

Collector-base voltage

$$\text{open emitter, } I_C = 3\text{ mA} \quad V_{(BR)CBO} > 36\text{ V}$$

Collector-emitter voltage

$$\text{open base, } I_C = 25\text{ mA} \quad V_{(BR)CEO} > 18\text{ V}$$

Emitter-base voltage

$$\text{open collector; } I_E = 3\text{ mA} \quad V_{(BR)EBO} > 4\text{ V}$$

Transient energy

$$L = 25\text{ mH; } f = 50\text{ Hz}$$

open base

$$-V_{BE} = 1.5\text{ V; } R_{BE} = 33\text{ }\Omega \quad E > 2.0\text{ mS}$$

$$E > 4.5\text{ mS}$$

D.C. current gain

$$I_C = 500\text{ mA; } V_{CE} = 5\text{ V} \quad h_{FE} > 5$$

Transition frequency

$$I_C = 1\text{ A; } V_{CE} = 10\text{ V} \quad f_T \text{ typ. } 700\text{ MHz}$$

Collector capacitance at  $f = 1\text{ MHz}$ 

$$I_E = I_e = 0; V_{CB} = 15\text{ V} \quad C_c \text{ typ. } 34\text{ pF}$$

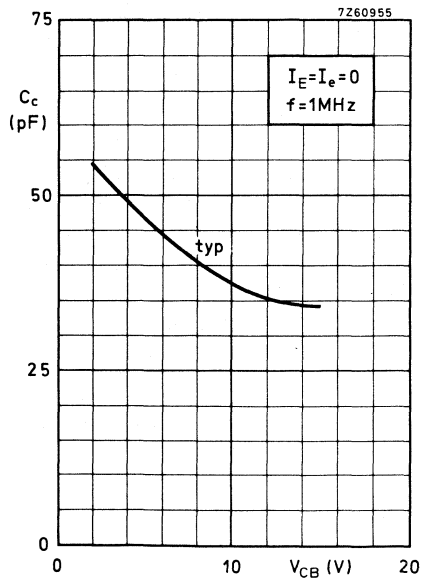
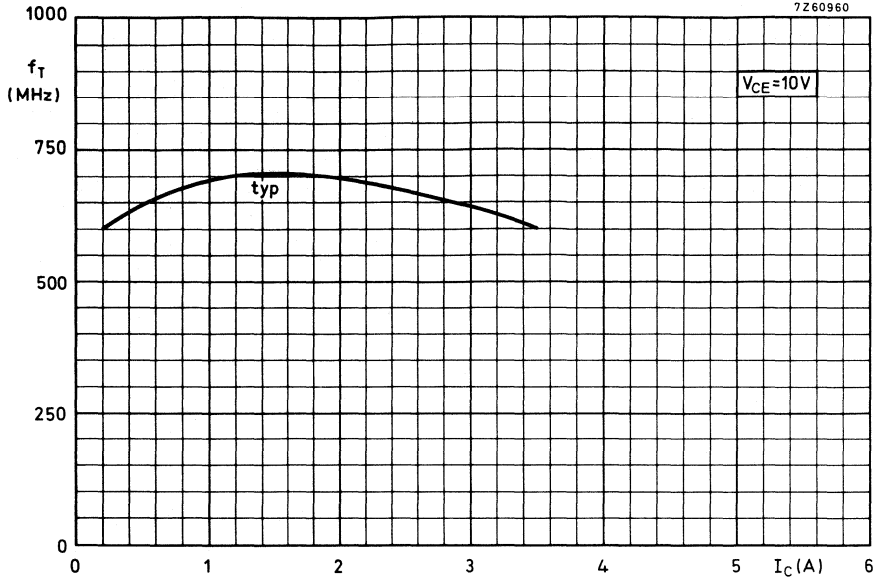
$$< 40\text{ pF}$$

Feedback capacitance at  $f = 1\text{ MHz}$ 

$$I_C = 100\text{ mA; } V_{CE} = 15\text{ V} \quad -C_{re} \text{ typ. } 25\text{ pF}$$

Collector-stud capacitance

$$C_{cs} \text{ typ. } 2\text{ pF}$$



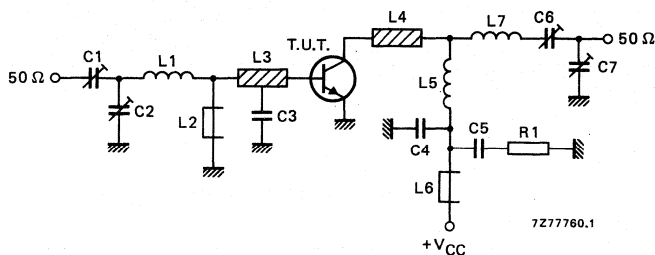
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

$f = 175 \text{ MHz}$ ;  $T_{mb}$  up to  $25^\circ\text{C}$

$V_{CC}(\text{V})$	$P_S(\text{W})$	$P_L(\text{W})$	$I_C(\text{A})$	$G_p(\text{dB})$	$\eta(\%)$	$\bar{z}_i(\Omega)$	$\bar{Y}_L(\text{mS})$
13.5	< 2.65	15	< 1.71	> 7.5	> 65	$2.3 + j2.2$	$128 - j4.4$
12.5	typ. 2.65	15	typ. 1.85	typ. 7.5	typ. 65	—	—

Test circuit



List of components:

C1 = 2.5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 2 turns Cu wire (1.6 mm); int. dia. 4.5 mm; length 5.7 mm; leads 2 x 5 mm

L2 = L6 = Ferroxcube wide-band h. f. choke, grade 3B (cat. no. 4312 020 36640)

L3 = L4 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

L5 = 3 turns Cu wire (1.6 mm); int. dia. 7.5 mm; length 7.5 mm; leads 2 x 5 mm

L7 = 3 turns Cu wire (1.6 mm); int. dia. 6.5 mm; length 7.4 mm; leads 2 x 5 mm

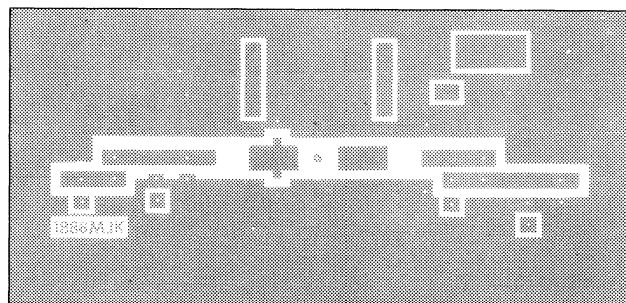
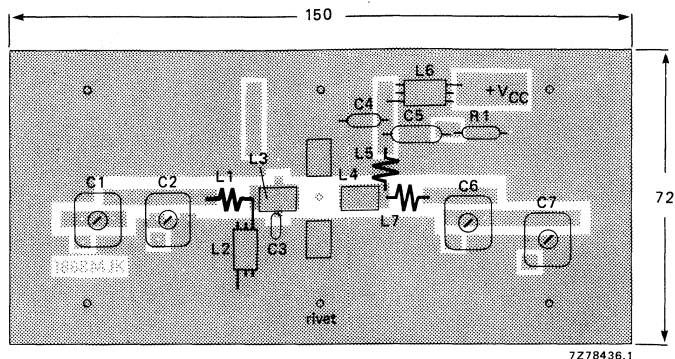
L3 and L4 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see following page.

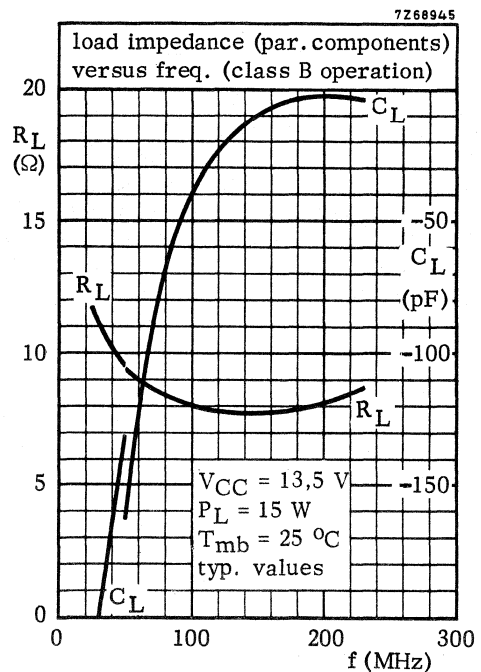
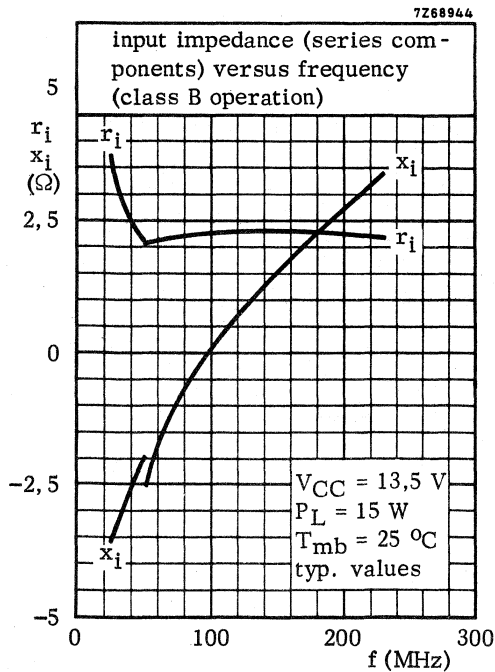
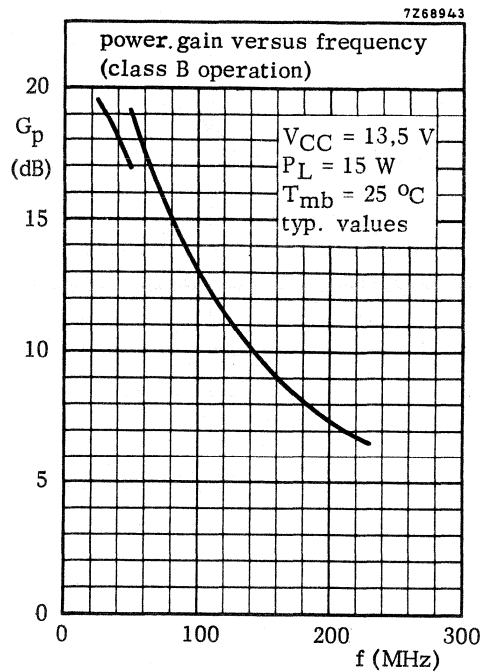
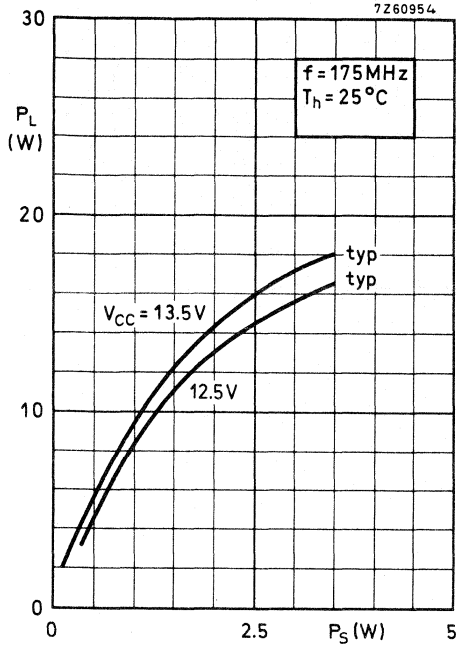
**APPLICATION INFORMATION** (continued)

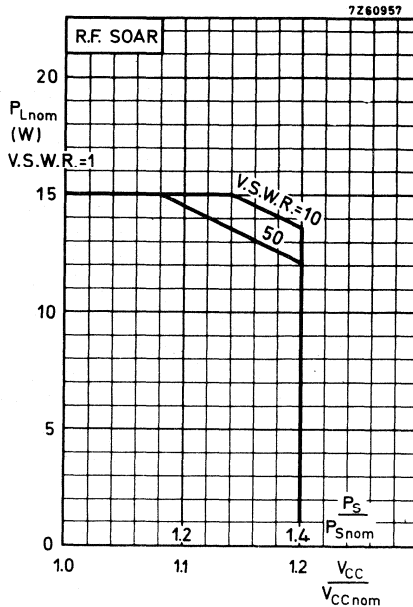
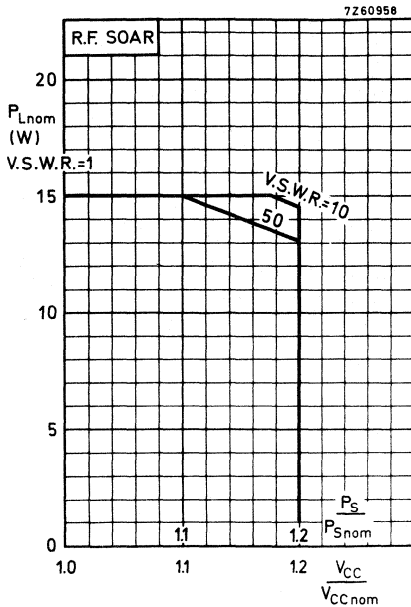
Component lay-out and printed circuit board for 175 MHz test circuit.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

**OPERATING NOTE** Below 50 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





Conditions for R. F. SOAR:

$f = 175 \text{ MHz}$        $P_{Snom} = P_S \text{ at } V_{CC} = V_{CCnom} \text{ and } V.S.W.R. = 1$   
 $T_h = 70 \text{ }^\circ\text{C}$        $R_{th mb-h} = 0.6 \text{ K/W}$   
 $V_{CCnom} = 12.5 \text{ or } 13.5 \text{ V}$       see also page 5

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graphs above for safe operation at supply voltages other than the nominal. The graphs show the allowable output power under nominal conditions, as a function of the supply overvoltage ratio, with V. S. W. R. as parameter.

The left hand graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply overvoltage ratio.

The right hand graph shows the derating factor to be applied when the drive ( $P_S/P_{Snom}$ ) increases as the square of the supply overvoltage ratio ( $V_{CC}/V_{CCnom}$ ).

Depending on the operating conditions, the appropriate derating factor may lie in the region between the linear and the square-law functions.

### V.H.F. POWER TRANSISTOR

N-P-N epitaxial planar transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 13,5 V. The transistor is resistance stabilized. Every transistor is tested under severe load mismatch conditions with a supply over-voltage to 16,5 V. It has a ¼" capstan envelope with a moulded cap. All leads are isolated from the stud.

#### QUICK REFERENCE DATA

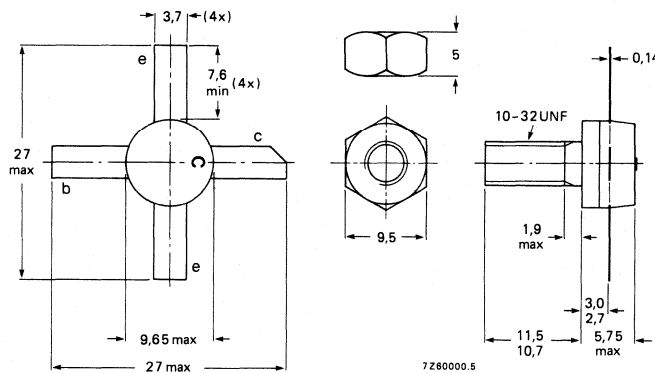
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_p$ dB	$\eta$ %	$\bar{z}_j$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	< 6,25	25	< 2,64	> 6	> 70	$1,6 + j1,4$	$213 + j5,5$

#### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-56.



Torque on nut: min. 1,5 Nm  
(15 kg cm)  
max. 1,7 Nm  
(17 kg cm)

Diameter of clearance hole in heatsink: max. 4,9 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer  
or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)  
peak value

$V_{CBOM}$  max. 36 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 18 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

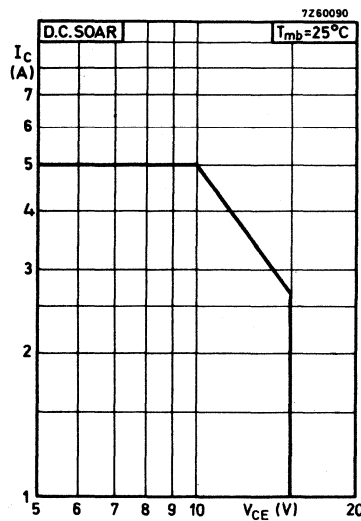
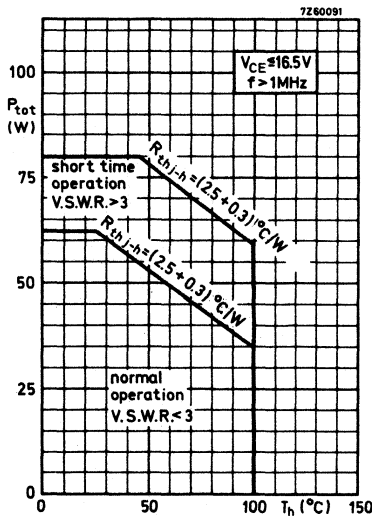
$I_{C(AV)}$  max. 5 A

Collector current (peak value)  $f > 1$  MHz

$I_{CM}$  max. 10 A

Total power dissipation up to  $T_{mb} = 25$  °C  
 $f > 1$  MHz

$P_{tot}$  max. 70 W



Storage temperature

$T_{stg}$  -30 to +200 °C

Operating junction temperature

$T_j$  max. 200 °C

**THERMAL RESISTANCE**

From junction to mounting base

$R_{th j-mb} = 2.5$  K/W

From mounting base to heatsink

$R_{th mb-h} = 0.3$  K/W



## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage open emitter, $I_C = 50\text{ mA}$	$V_{(BR)CBO}$	>	36	V
Collector-emitter voltage open base, $I_C = 50\text{ mA}$	$V_{(BR)CEO}$	>	18	V
Emitter-base voltage open collector; $I_E = 10\text{ mA}$	$V_{(BR)EBO}$	>	4	V

## Transient energy

$L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$

open base	E	>	8	ms
$-V_{BE} = 1.5\text{ V}$ ; $R_{BE} = 33\Omega$	E	>	8	ms

## D.C. current gain

$I_C = 1\text{ A}$ ;  $V_{CE} = 5\text{ V}$

$h_{FE}$	typ.	50
	10 to	120

## Transition frequency

$I_C = 4\text{ A}$ ;  $V_{CE} = 10\text{ V}$

$f_T$	typ.	650	MHz
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Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0$ ;  $V_{CB} = 15\text{ V}$

$C_c$	typ.	65	pF
	<	90	pF

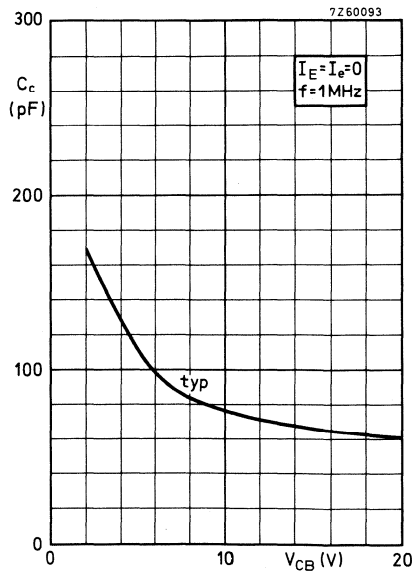
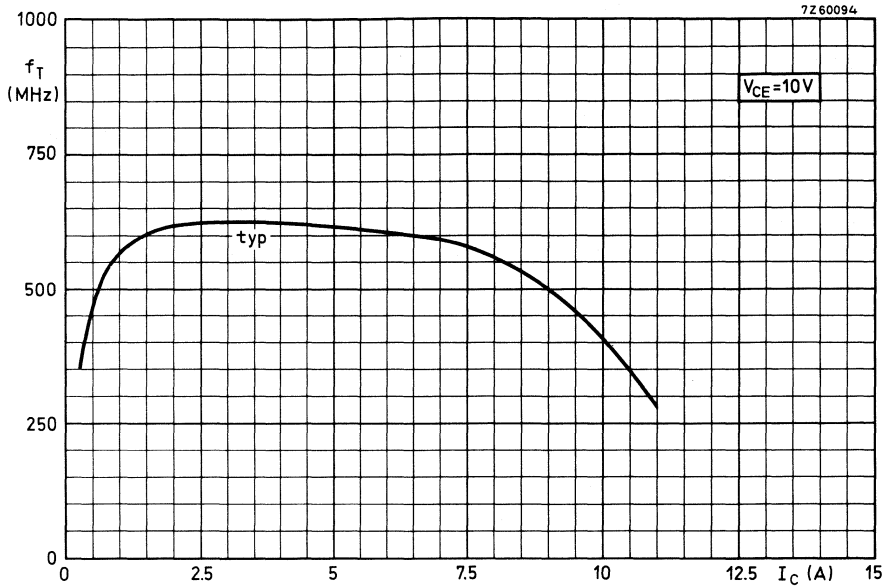
Feedback capacitance at  $f = 1\text{ MHz}$ 

$I_C = 100\text{ mA}$ ;  $V_{CE} = 15\text{ V}$

$C_{re}$	typ.	41	pF
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## Collector-stud capacitance

$C_{cs}$	typ.	2	pF
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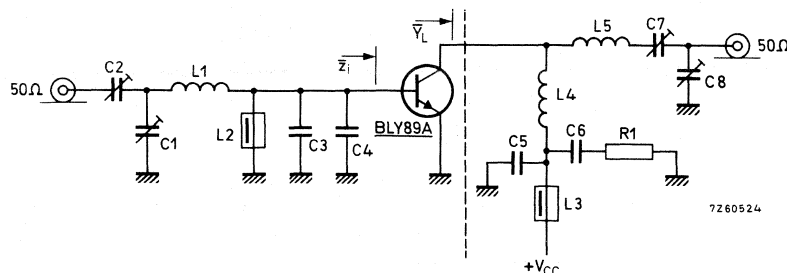
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

$$V_{CC} = 13.5 \text{ V}; T_{mb} \text{ up to } 25^\circ\text{C}$$

f(MHz)	PS (W)	PL (W)	IC (A)	G <sub>p</sub> (dB)	η (%)	$\bar{z}_i (\Omega)$	$\bar{Y}_L (\text{mS})$
175	< 6.25	25	< 2.64	> 6	> 70	1.6+j1.4	213 + j5.5

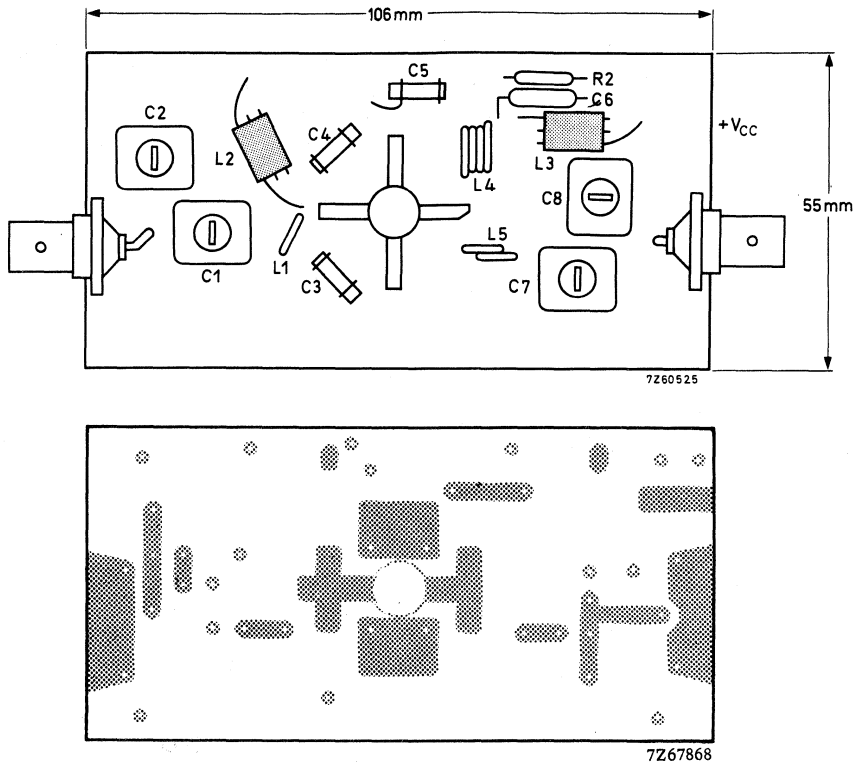
Test circuit



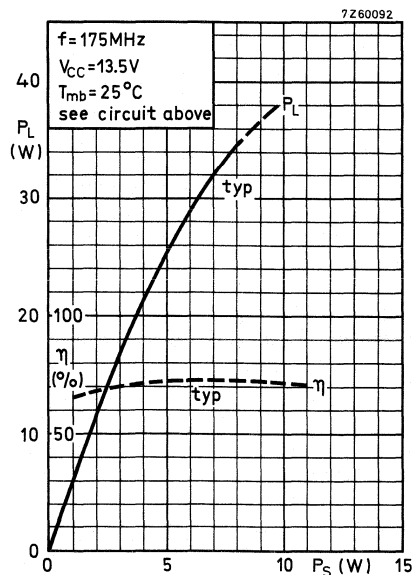
- C1 = 4 to 44 pF film dielectric trimmer (code number 2222 809 07008)  
 C2 = 2 to 22 pF film dielectric trimmer (code number 2222 809 07004)  
 C3 = C4 = 47 pF ceramic  
 C5 = 100 pF ceramic  
 C6 = 150 nF polyester  
 C7 = 4 to 104 pF film dielectric trimmer (code number 2222 809 07015)  
 C8 = 4 to 64 pF film dielectric trimmer (code number 2222 809 07011)
- L1 = 0.5 turn enamelled Cu wire (1.5 mm); int.diam. 6 mm; leads 2x6 mm  
 L2 = L3 = ferrocube choke (code number 4312 020 36640)  
 L4 = 3.5 turns closely wound enamelled Cu wire (1.5 mm); int.diam. 6 mm; leads 2x6 mm  
 L5 = 1 turn enamelled Cu wire (1.5 mm); int.diam. 6 mm; leads 2x6 mm  
 R1 = 10 Ω carbon

**APPLICATION INFORMATION** (continued)

Component lay-out and printed circuit board for 175 MHz test circuit.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallised to serve as earth. Earth connections are made by means of hollow rivets.

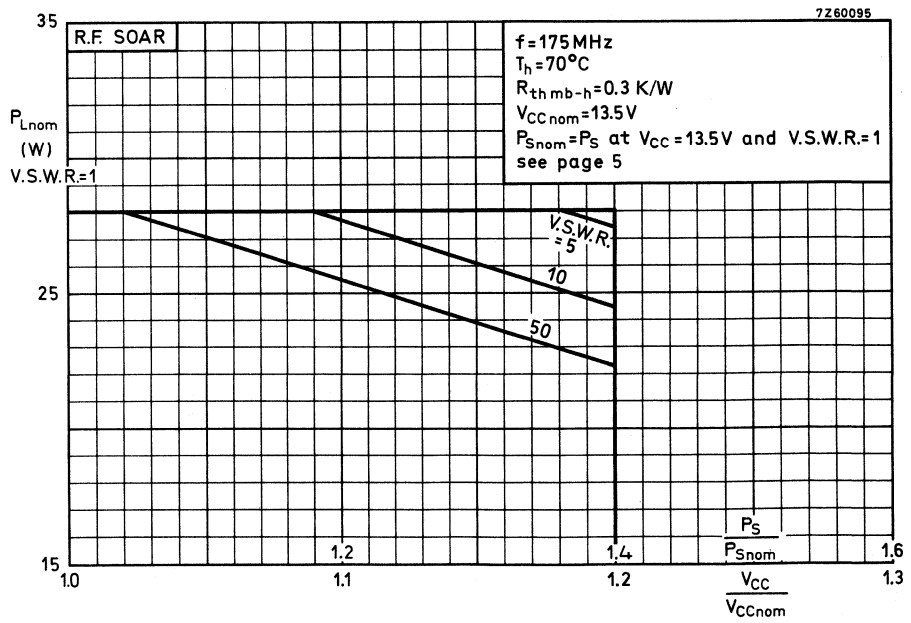
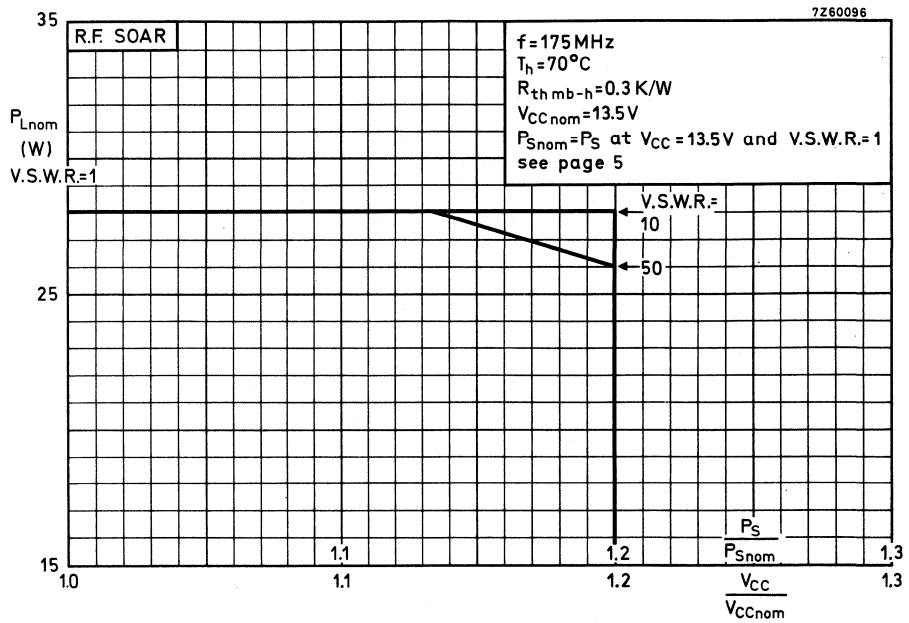


The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graphs next page for safe operation at supply voltages other than the nominal. The graphs show the allowable output power under nominal conditions, as a function of the supply overvoltage ratio, with V.S.W.R. as parameter.

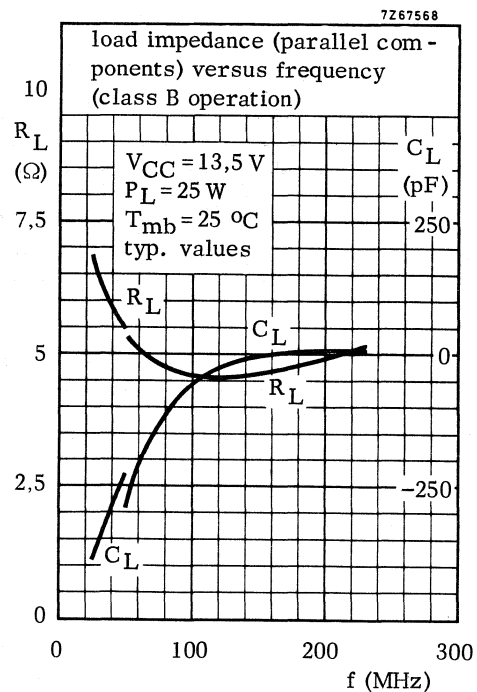
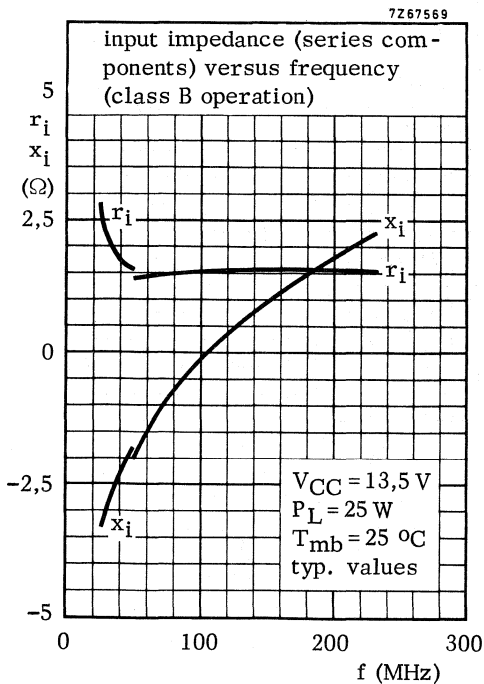
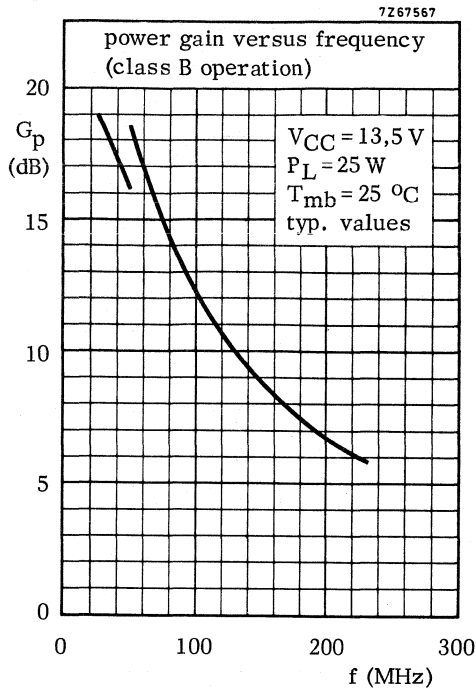
The upper graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply overvoltage ratio.

The lower graph shows the derating factor to be applied when the drive ( $P_S/P_{Snom}$ ) increases as the square of the supply overvoltage ratio ( $V_{CC}/V_{CCnom}$ ).

Depending on the operating conditions, the appropriate derating factor may lie in the region between the linear and the square-law functions.



**OPERATING NOTE** Below 50 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.







## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a nominal supply voltage of 13,5 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions with a supply over-voltage to 16,5 V. It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

## QUICK REFERENCE DATA

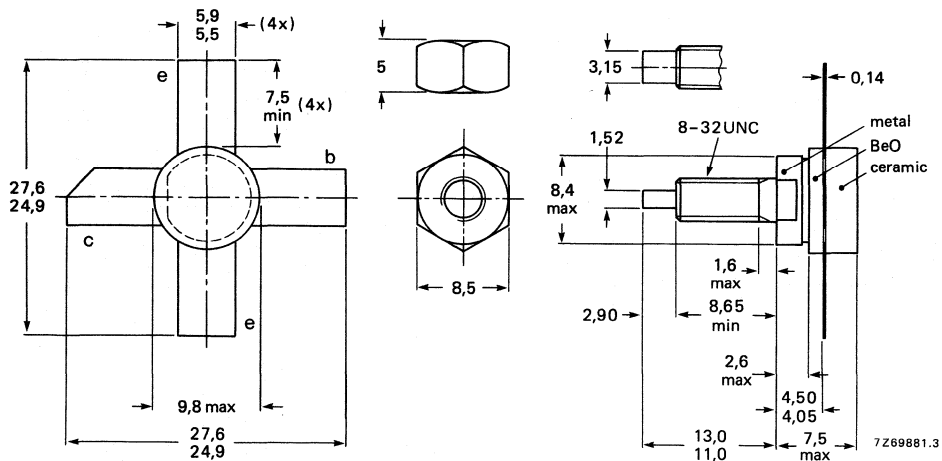
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CC}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	13,5	175	25	> 6	> 70	$1,6 + j1,4$	$210 + j5,5$

## MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min 0,75 Nm  
(7,5 kg cm)  
max 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink:  
max 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not  
chamfer or countersink either end of hole.

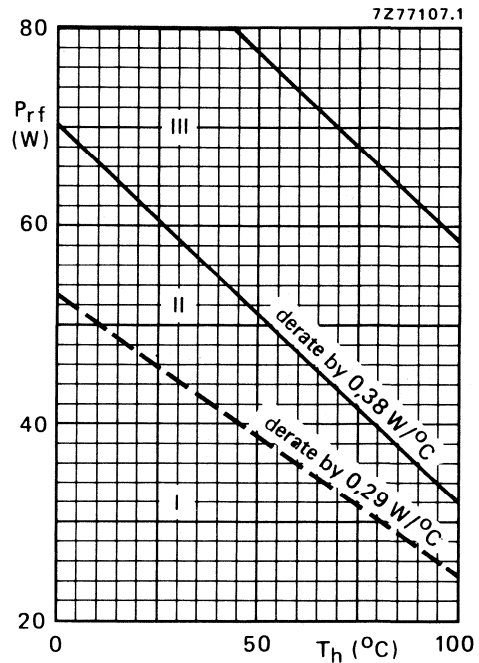
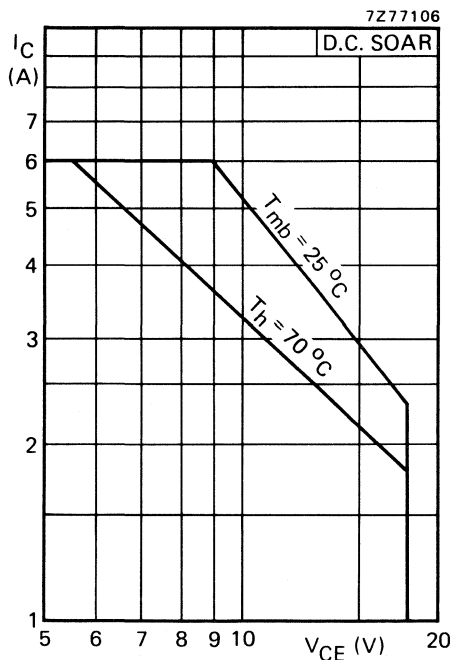
When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

## RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max	36 V
Collector-emitter voltage (open base)	$V_{CEO}$	max	18 V
Emitter-base voltage (open collector)	$V_{EBO}$	max	4 V
Collector current (average)	$I_C(AV)$	max	6 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max	12 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25^\circ\text{C}$	$P_{rf}$	max	73 W



R.F. power dissipation;  $V_{CE} \leq 16,5\text{ V}$ ;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation 20 W;  $T_{mb} = 79^\circ\text{C}$ , i.e.  $T_h = 70^\circ\text{C}$ )

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	3,1 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	2,3 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,45 K/W

**CHARACTERISTICS** $T_j = 25\text{ }^\circ\text{C}$ **Breakdown voltage**

Collector-emitter voltage

 $V_{BE} = 0; I_C = 25\text{ mA}$  $V_{(BR)CES} > 36\text{ V}$ 

Collector-emitter voltage

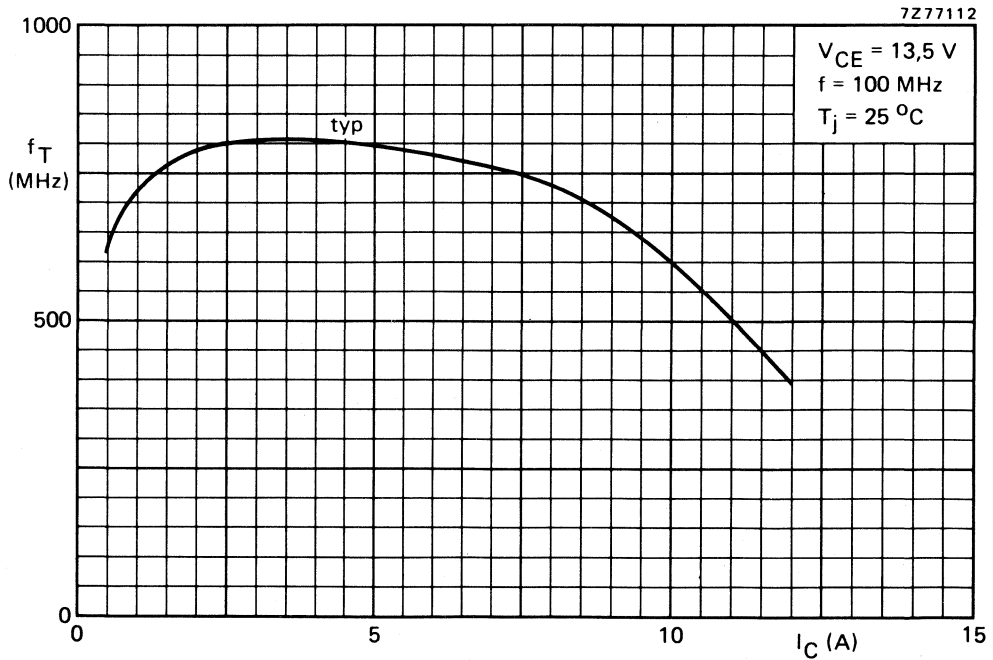
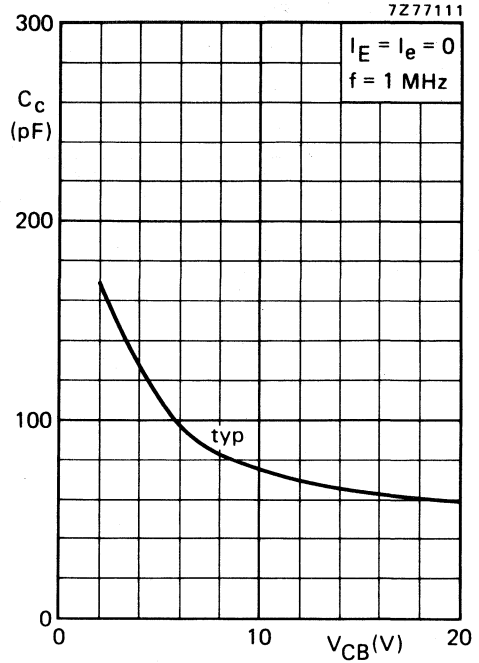
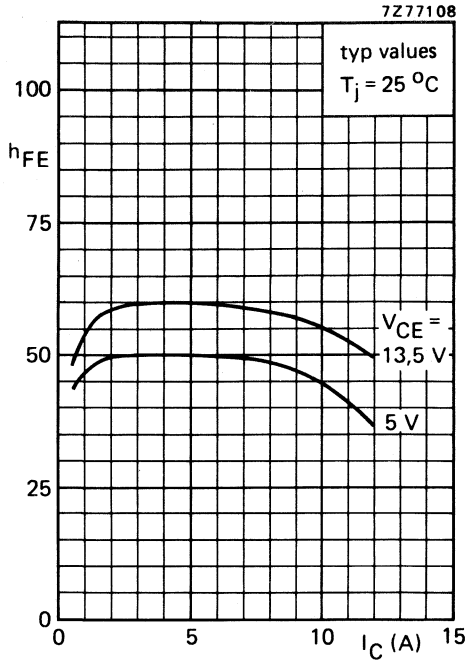
open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 18\text{ V}$ 

Emitter-base voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ **Collector cut-off current** $V_{BE} = 0; V_{CE} = 18\text{ V}$  $I_{CES} < 10\text{ mA}$ **Transient energy** $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $-V_{BE} = 1,5\text{ V}; R_{BE} = 33\text{ }\Omega$  $E > 8\text{ ms}$  $E > 8\text{ ms}$ **D.C. current gain\*** $I_C = 2,5\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ 50  
10 to 80**Collector-emitter saturation voltage\*** $I_C = 7,5\text{ A}; I_B = 1,5\text{ A}$  $V_{CEsat}$  typ 1,7 V**Transition frequency at  $f = 100\text{ MHz}$ \*** $I_C = 2,5\text{ A}; V_{CE} = 13,5\text{ V}$  $I_C = 7,5\text{ A}; V_{CE} = 13,5\text{ V}$  $f_T$  typ 800 MHz  
 $f_T$  typ 750 MHz**Collector capacitance at  $f = 1\text{ MHz}$**  $I_E = I_e = 0; V_{CB} = 15\text{ V}$  $C_c$  typ 65 pF  
< 90 pF**Feedback capacitance at  $f = 1\text{ MHz}$**  $I_C = 100\text{ mA}; V_{CE} = 15\text{ V}$  $C_{re}$  typ 41 pF**Collector-stud capacitance** $C_{cs}$  typ 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .



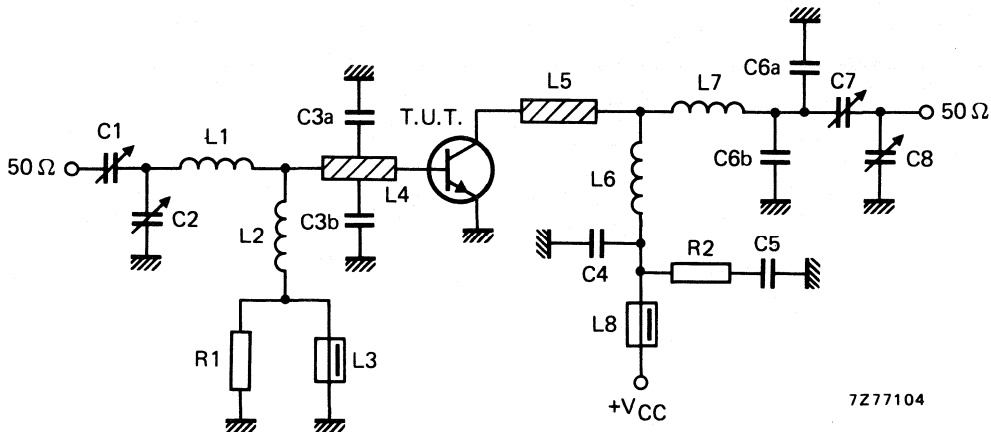
## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	V <sub>CC</sub> (V)	P <sub>L</sub> (W)	P <sub>S</sub> (W)	G <sub>p</sub> (dB)	I <sub>C</sub> (A)	η (%)	$\bar{z}_i(\Omega)$	$\bar{Y}_L$ (mS)
175	13,5	25	<6,25	> 6	<2,64	> 70	1,6 + j1,4	210 + j5,5
175	12,5	25	—	typ 6,6	—	typ 75	—	—

Test circuit for 175 MHz



7Z77104

List of components:

C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C8 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor

C5 = 100 nF polyester capacitor

C6a = C6b = 8,2 pF ceramic capacitor (500 V)

C7 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

L1 = 1 turn enamelled Cu wire (1,6 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube choke coil (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

L6 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 5,0 mm; length 6,0 mm; leads 2 x 5 mm

L7 = 2 turns enamelled Cu wire (1,6 mm); int. dia. 4,5 mm; length 6,0 mm; leads 2 x 5 mm

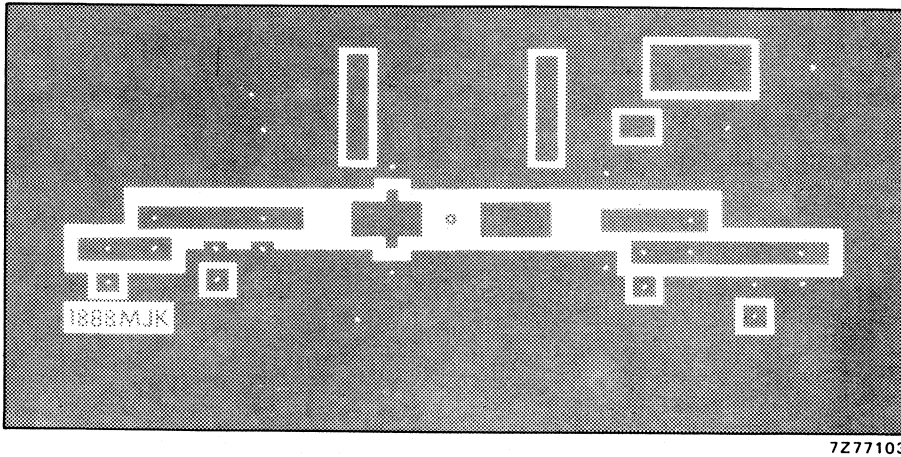
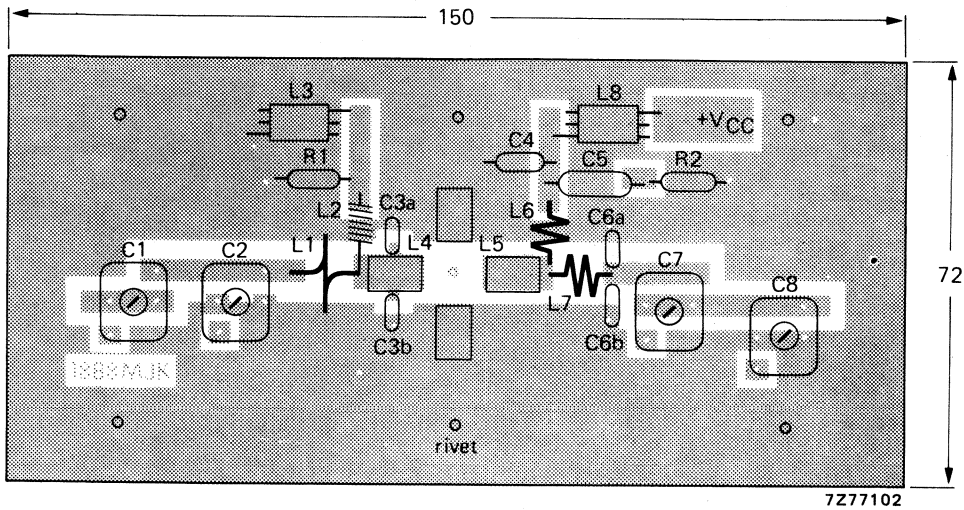
L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = 10 Ω (±10%) carbon resistor

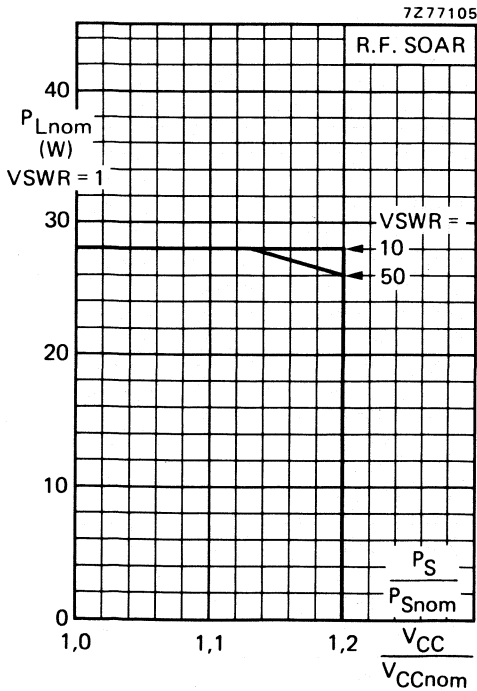
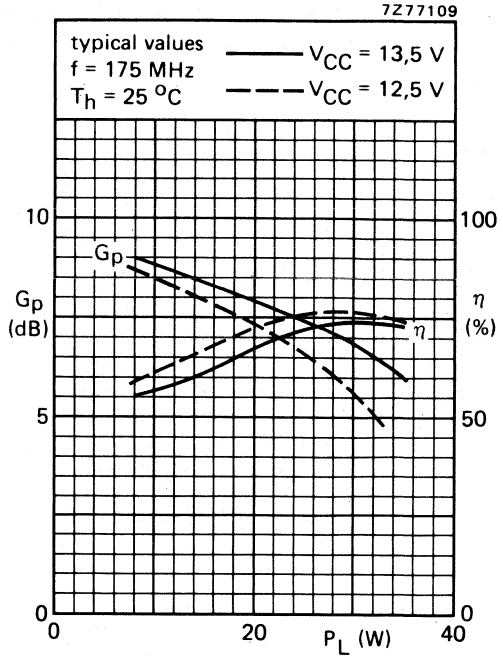
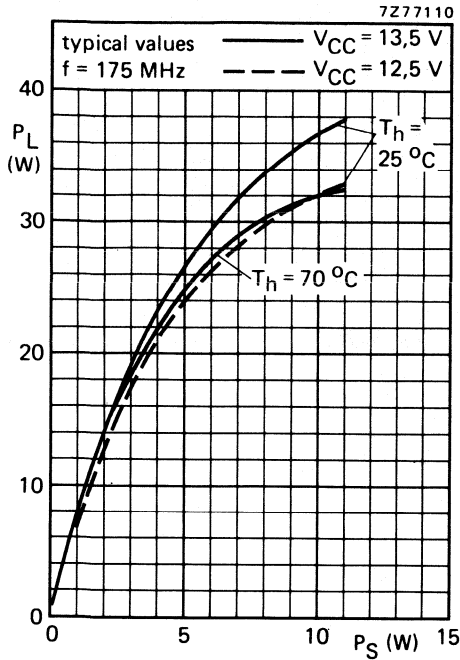
R2 = 4,7 Ω (±5%) carbon resistor

APPLICATION INFORMATION (continued)

Component layout and printed-circuit board for 175 MHz test circuit.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.



**Conditions for R.F. SOAR**

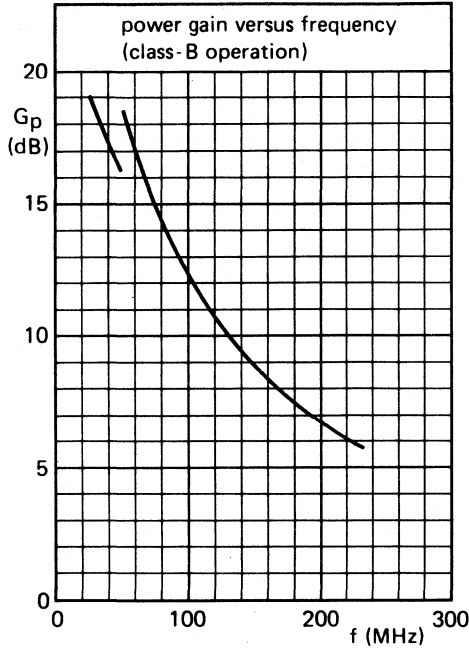
$f = 175 \text{ MHz}$   
 $T_h = 70 \text{ }^\circ\text{C}$   
 $R_{th \text{ mb-h}} = 0,45 \text{ K/W}$   
 $V_{CCnom} = 13,5 \text{ V}$   
 $P_S = P_{Snom}$  at  $V_{CCnom} = 13,5 \text{ V}$  and  $VSWR = 1$   
 see page 5

The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power must be derated in accordance with the graph for safe operation at supply voltages other than the nominal. The graph shows the permissible output power under nominal conditions ( $VSWR = 1$ ), as a function of the expected supply over-voltage ratio with  $VSWR$  as parameter.

The graph applies to the situation in which the drive ( $P_S/P_{Snom}$ ) increases linearly with supply over-voltage ratio.

**OPERATING NOTE** Below 50 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

7Z67567



**Measuring conditions for the graphs on this page**

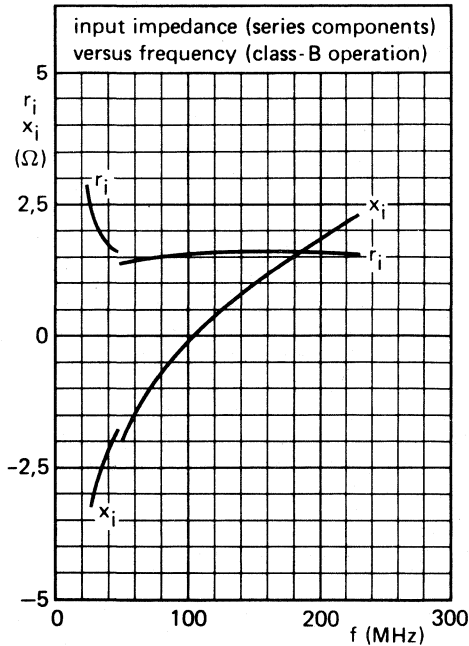
$V_{CC} = 13,5$  V

$P_L = 25$  W

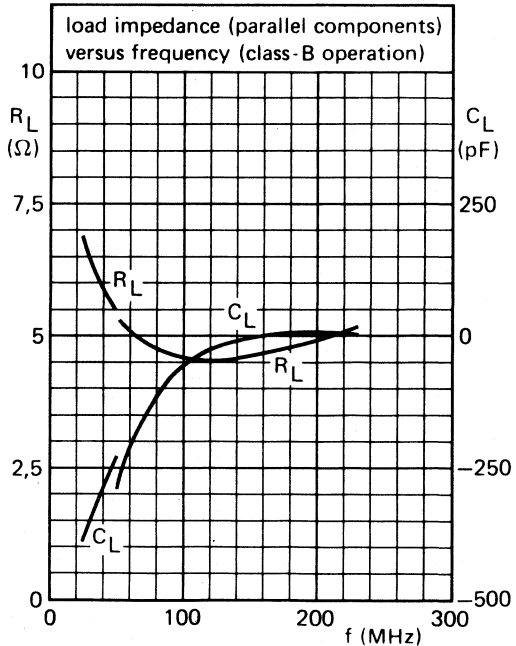
$T_h = 25$  °C

typical values

7Z67569



7Z67568





## V.H.F. POWER TRANSISTOR

N-P-N epitaxial planar transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 12,5 V. The transistor is resistance stabilized. Every transistor is tested under severe load mismatch conditions with a supply over-voltage to 15 V. It has a plastic encapsulated stripline package. All leads are isolated from the stud.

### QUICK REFERENCE DATA

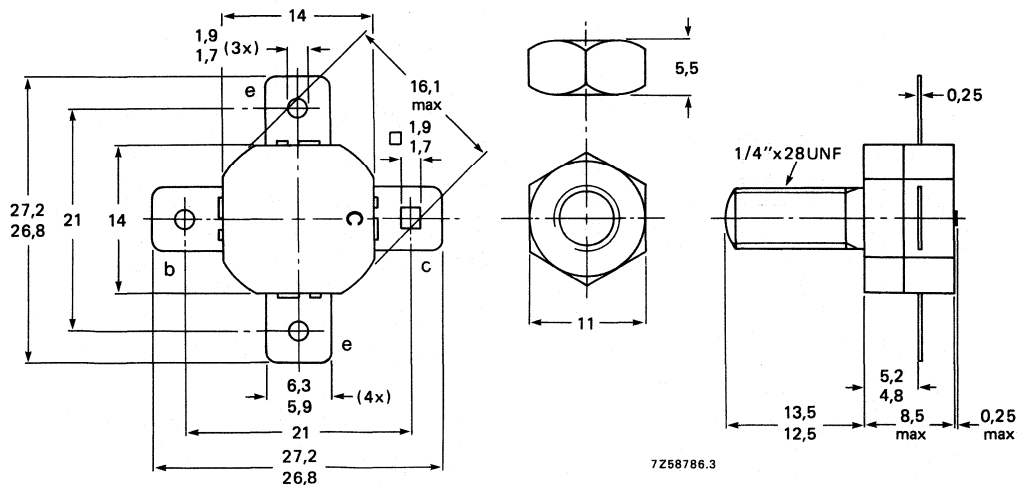
R.F. performance up to  $T_h = 25^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	12,5	175	< 15,8	50	< 5,33	> 5,0	> 75	$1,3 + j1,6$	$270 + j170$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-55.



Torque on nut: min. 2,3 Nm  
(23 kg cm)  
max. 2,7 Nm  
(27 kg cm)

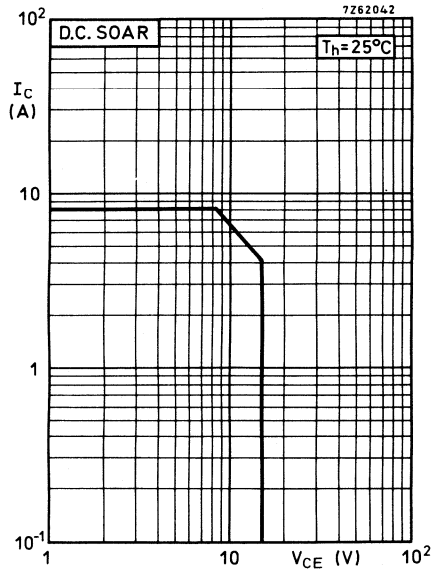
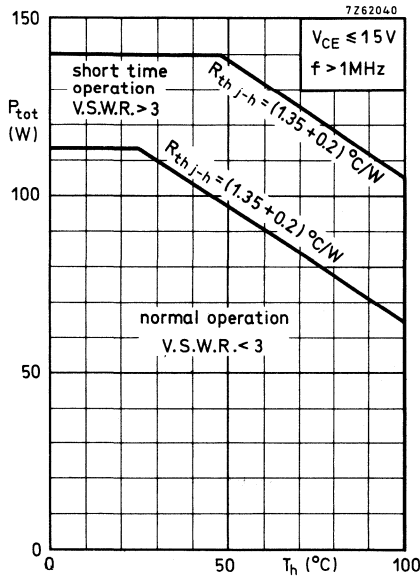
Diameter of clearance hole in heatsink: max. 6,4 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer  
or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$	max.	36	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	18	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4	V
Collector current (average)	$I_C(AV)$	max.	8	A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$	max.	20	A
Total power dissipation up to $T_{mb} = 25^\circ C$ $f > 1$ MHz	$P_{tot}$	max.	130	W



Storage temperature  
Operating junction temperature

$T_{stg}$	-65 to +200	$^\circ C$
$T_j$	max. 200	$^\circ C$

**THERMAL RESISTANCE**

From junction to mounting base  
From mounting base to heatsink

$R_{th j-mb}$	=	1.35	K/W
$R_{th mb-h}$	=	0.2	K/W

## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage  
open emitter,  $I_C = 100\text{ mA}$   $V_{(BR)CBO} > 36\text{ V}$

Collector-emitter voltage  
open base,  $I_C = 100\text{ mA}$   $V_{(BR)CEO} > 18\text{ V}$

Emitter-base voltage  
open collector,  $I_E = 25\text{ mA}$   $V_{(BR)EBO} > 4\text{ V}$

## Transient energy

$L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$

open base  $E > 8\text{ ms}$   
 $-V_{BE} = 1.5\text{ V}$ ;  $R_{BE} = 33\Omega$   $E > 8\text{ ms}$

## D. C. current gain

$I_C = 1\text{ A}$ ;  $V_{CE} = 5\text{ V}$   $h_{FE} > 10$   
typ. 50

## Transition frequency

$I_C = 6\text{ A}$ ;  $V_{CE} = 10\text{ V}$   $f_T$  typ. 550 MHz

Collector capacitance at  $f = 1\text{ MHz}$ 

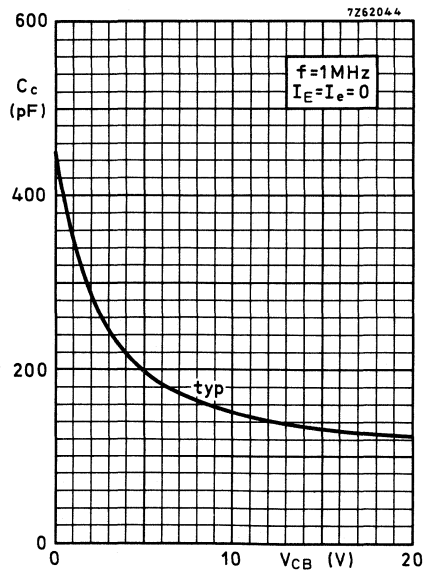
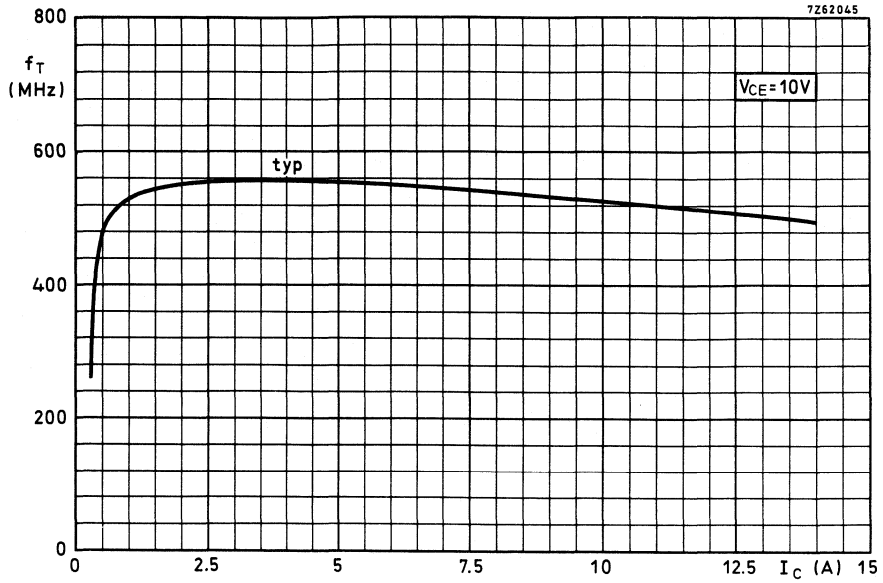
$I_E = I_e = 0$ ;  $V_{CB} = 15\text{ V}$   $C_c$  typ. 130 pF  
< 160 pF

## Feedback capacitance

$I_C = 200\text{ mA}$ ;  $V_{CE} = 15\text{ V}$   $-C_{re}$  typ. 82 pF

## Collector-stud capacitance

$C_{cs}$  typ. 3.5 pF



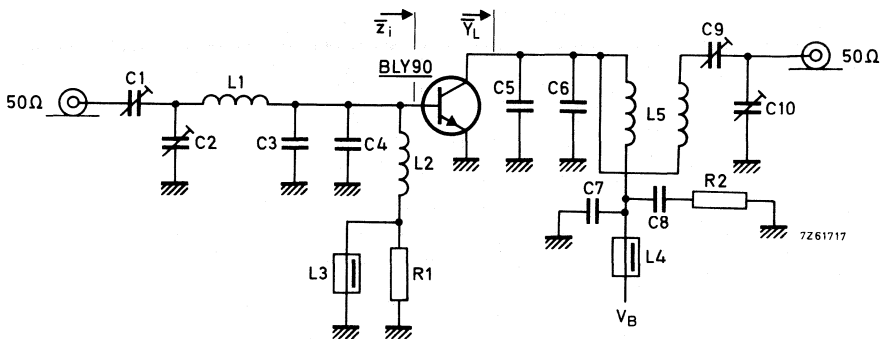
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralized common-emitter class-B circuit)

 $f = 175 \text{ MHz}$ ;  $T_h$  up to  $25 \text{ }^\circ\text{C}$ 

$V_{CC}$ (V)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
12,5	< 15,8	50	< 5,33	> 5,0	> 75	$1,3 + j 1,6$	$270 + j 170$

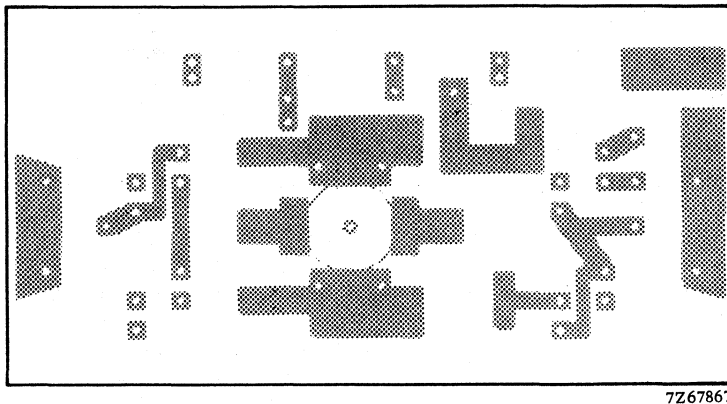
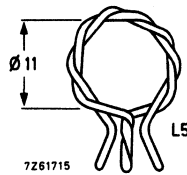
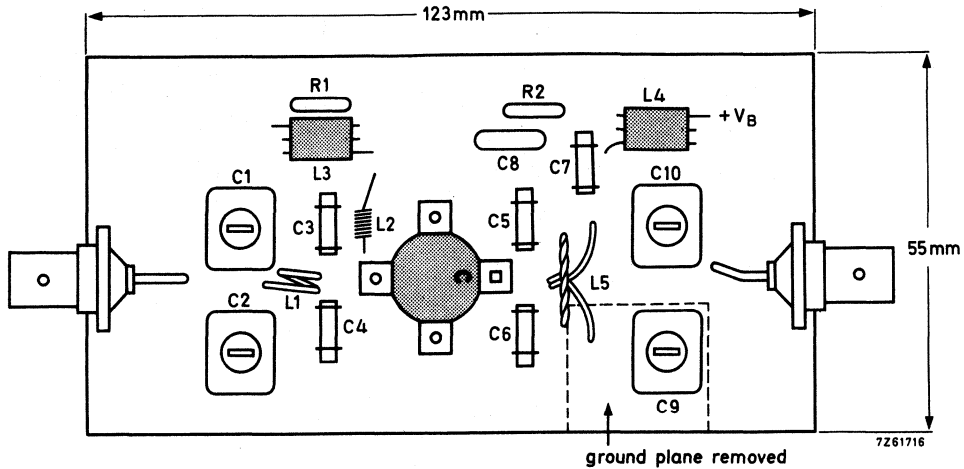
Test circuit for 175 MHz:



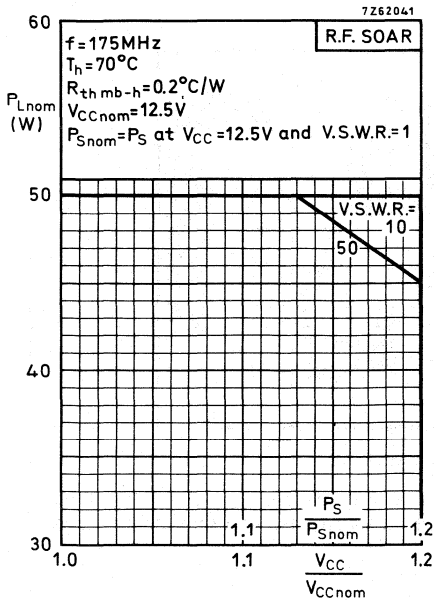
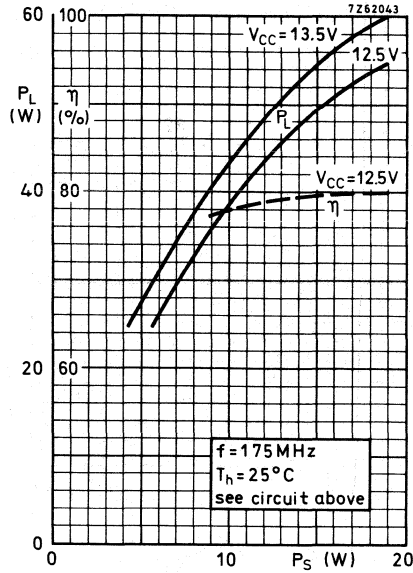
- C1 = 2 to 20 pF film dielectric trimmer  
 C2 = 4 to 40 pF film dielectric trimmer  
 C3 = C4 = 27 pF ceramic capacitor  
 C5 = C6 = 56 pF ceramic capacitor  
 C7 = 100 pF ceramic capacitor  
 C8 = 100 nF polyester capacitor  
 C9 = 4 to 80 pF film dielectric trimmer  
 C10 = 4 to 60 pF film dielectric trimmer  
 L1 = 1,5 turns enamelled Cu wire (1,5 mm); int. dia. 6 mm; length 4 mm; leads 2 x 5 mm  
 L2 = 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm  
 L3 = L4 = Ferroxcube choke (code number 4312 020 36640)  
 L5 = bifilar wound enamelled Cu wire (1,0 mm); see figure on next page  
 R1 = 10  $\Omega$  carbon resistor  
 R2 = 4,7  $\Omega$  carbon resistor

APPLICATION INFORMATION (continued)

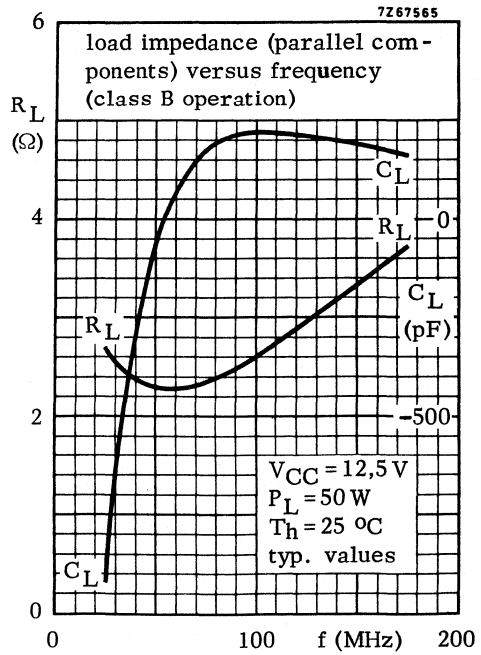
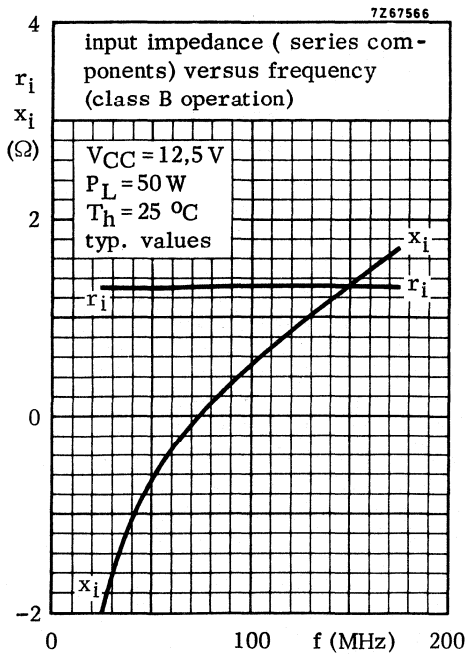
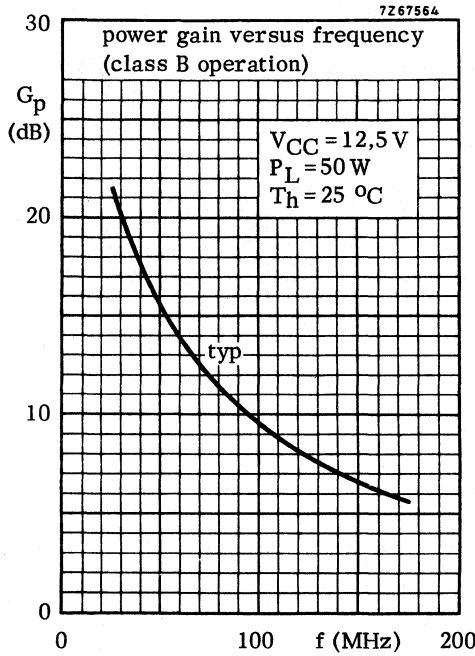
Component lay-out and printed circuit board for 175 MHz test circuit.



The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets.



The transistor has been developed for use with unstabilized supply voltages. As the output power and drive power increase with the supply voltage, the nominal output power ( $P_{L\text{nom}}$ ) must be derated in accordance with the adjacent graph for safe operation at supply voltage other than the nominal. The graph shows the allowable output power under nominal conditions, as a function of the supply overvoltage ratio with V.S.W.R. as parameter. The graph applies to the situation in which the drive ( $P_S/P_{S\text{nom}}$ ) increases linearly with supply overvoltage ratio ( $V_{CC}/V_{CC\text{nom}}$ ).





## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in class-A, B and C operated mobile, industrial and military transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

It has a 1/4" capstan envelope with a moulded cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

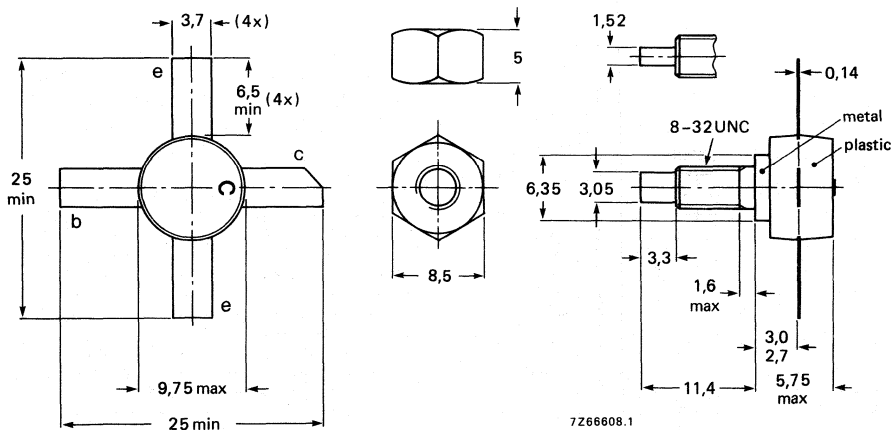
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	8	> 12	> 65	$1,8 + j0,7$	$18 - j20$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/2



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)  
peak value

$V_{CBOM}$  max. 65 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 36 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

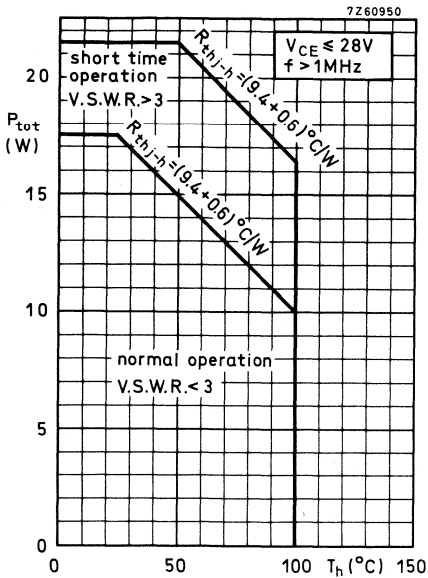
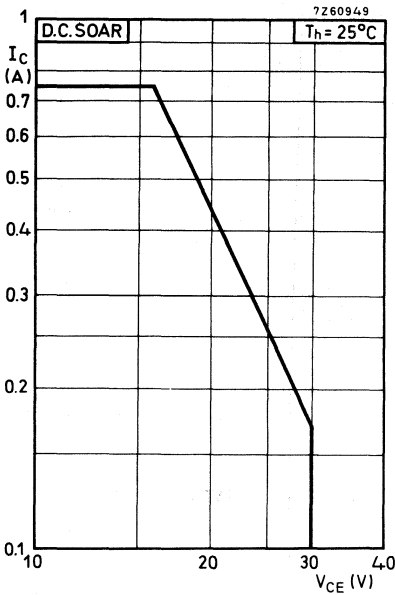
$I_{C(AV)}$  max. 0.75 A

Collector current (peak value)  $f > 1$  MHz

$I_{CM}$  max. 2.25 A

Total power dissipation up to  $T_h = 25^\circ\text{C}$   
 $f > 1$  MHz

$P_{tot}$  max. 17.5 W



Storage temperature

$T_{stg}$  -30 to +200 °C

Operating junction temperature

$T_j$  max. 200 °C

**THERMAL RESISTANCE**

From junction to mounting base

$R_{th\ j-mb} = 9.4$  K/W

From mounting base to heatsink

$R_{th\ mb-h} = 0.6$  K/W

## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$$I_B = 0; V_{CE} = 28 \text{ V} \quad I_{CEO} < 5 \text{ mA}$$

Breakdown voltages

$$\begin{array}{l} \text{Collector-base voltage} \\ \text{open emitter; } I_C = 1 \text{ mA} \end{array} \quad V_{(BR)CBO} > 65 \text{ V}$$

$$\begin{array}{l} \text{Collector-emitter voltage} \\ \text{open base, } I_C = 10 \text{ mA} \end{array} \quad V_{(BR)CEO} > 36 \text{ V}$$

$$\begin{array}{l} \text{Emitter-base voltage} \\ \text{open collector; } I_E = 1 \text{ mA} \end{array} \quad V_{(BR)EBO} > 4 \text{ V}$$

Transient energy

$$\begin{array}{l} L = 25 \text{ mH; } f = 50 \text{ Hz} \\ \text{open base} \\ -V_{BE} = 1.5 \text{ V; } R_{BE} = 33 \Omega \end{array} \quad \begin{array}{l} E > 0.5 \text{ ms} \\ E > 0.5 \text{ ms} \end{array}$$

D.C. current gain

$$I_C = 500 \text{ mA; } V_{CE} = 5 \text{ V} \quad h_{FE} > 5$$

Transition frequency

$$I_C = 400 \text{ mA; } V_{CE} = 20 \text{ V} \quad f_T \text{ typ. } 500 \text{ MHz}$$

Collector capacitance at  $f = 1 \text{ MHz}$

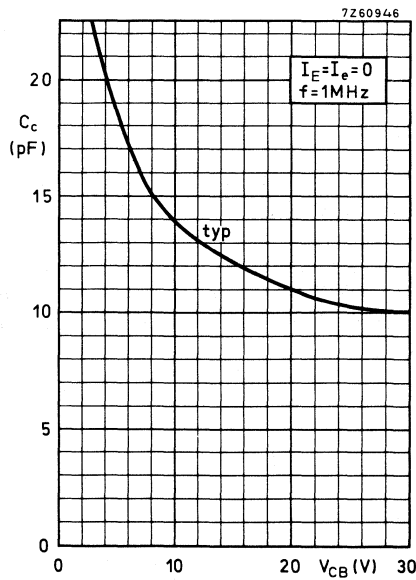
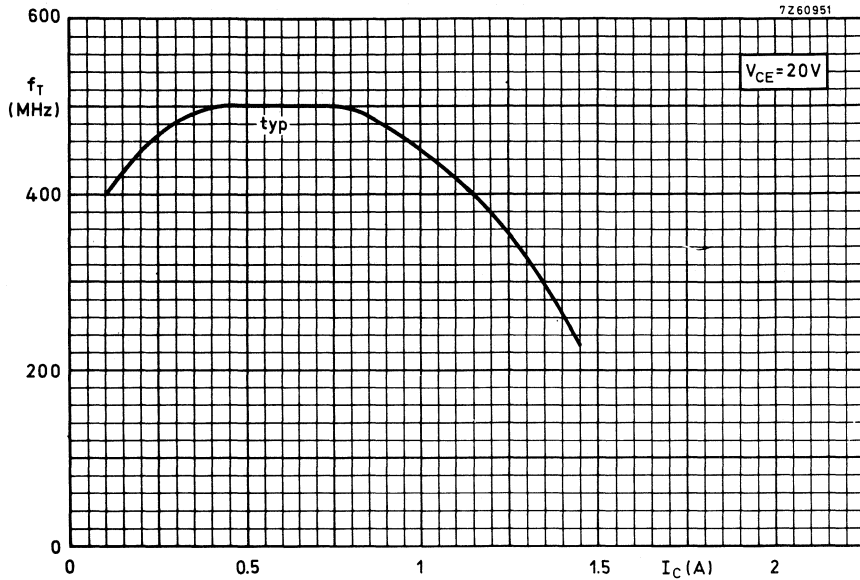
$$I_E = I_e = 0; V_{CB} = 30 \text{ V} \quad C_c \begin{array}{l} \text{typ. } 10 \text{ pF} \\ < 15 \text{ pF} \end{array}$$

Feedback capacitance at  $f = 1 \text{ MHz}$

$$I_C = 50 \text{ mA; } V_{CE} = 30 \text{ V} \quad C_{re} \text{ typ. } 7.5 \text{ pF}$$

Collector-stud capacitance

$$C_{cs} \text{ typ. } 2 \text{ pF}$$



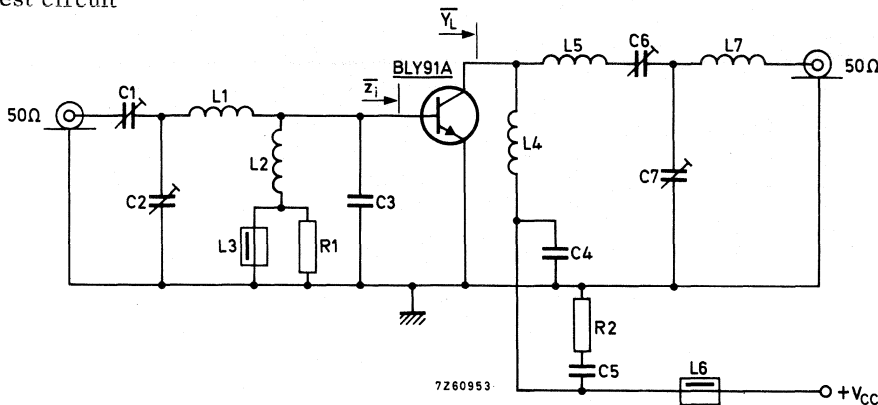
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

$$V_{CC} = 28 \text{ V}; T_{mb} \text{ up to } 25 \text{ }^{\circ}\text{C}$$

f(MHz)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	< 0.50	8	< 0.44	> 12	> 65	$1.8 + j0.7$	18-j20

Test circuit



- C1 = 2.5 to 20 pF film dielectric trimmer (code number 2222 809 07004)  
 C2 = C6 = C7 = 4 to 40 pF film dielectric trimmer (code number 2222 809 07008)  
 C3 = 47 pF ceramic  
 C4 = 100 pF ceramic  
 C5 = 150 nF polyester

- L1 = 0.5 turn enamelled Cu wire (1.5 mm); int. diam. 6 mm; leads 2 x 10 mm  
 L2 = 6.5 turns closely wound enamelled Cu wire (0.7 mm); int. diam. 4 mm;  
 leads 2 x 5 mm

- L3 = L6 = ferroxcube choke (code number 4312 020 36640)

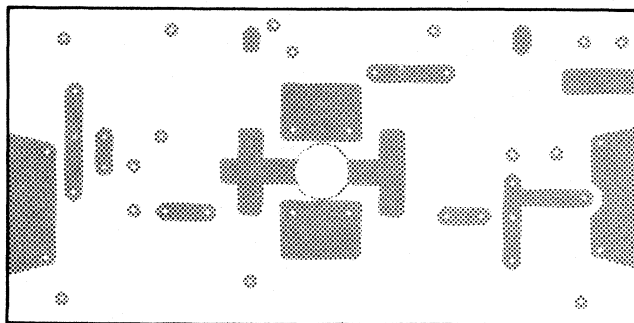
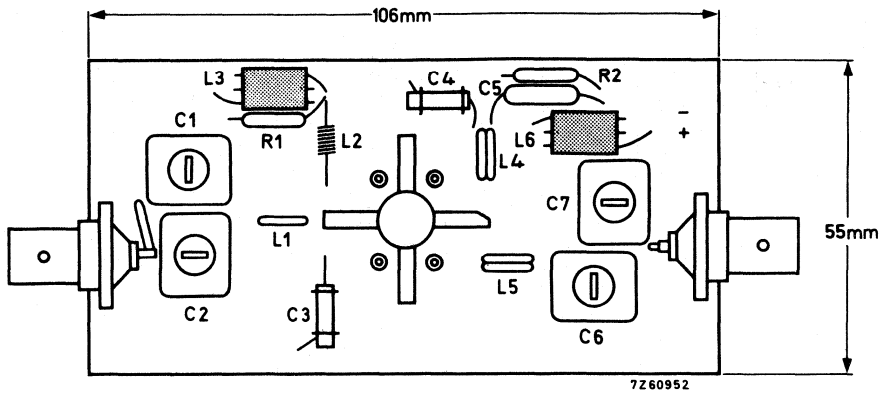
- L4 = 7.5 turns enamelled Cu wire (0.7 mm); int. diam. 4 mm; leads 2 x 5 mm  
 L5 = 4.5 turns enamelled Cu wire (0.7 mm); int. diam. 6 mm; leads 2 x 7 mm  
 L7 = 3.5 turns enamelled Cu wire (0.7 mm); int. diam. 6 mm; leads 2 x 7 mm

- R1 = R2 = 10  $\Omega$  carbon

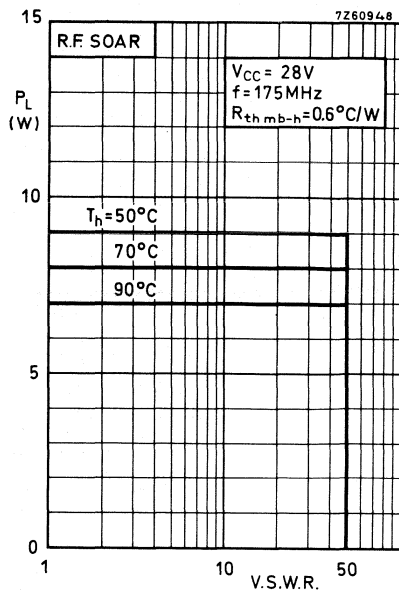
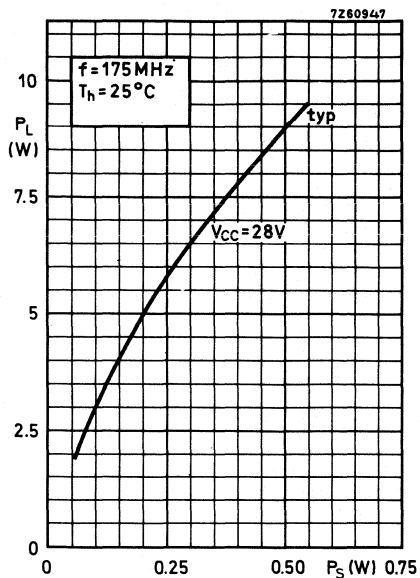
Component lay-out for 175 MHz test circuit see next page.

APPLICATION INFORMATION (continued)

Component lay-out and printed circuit board for 175 MHz test circuit.

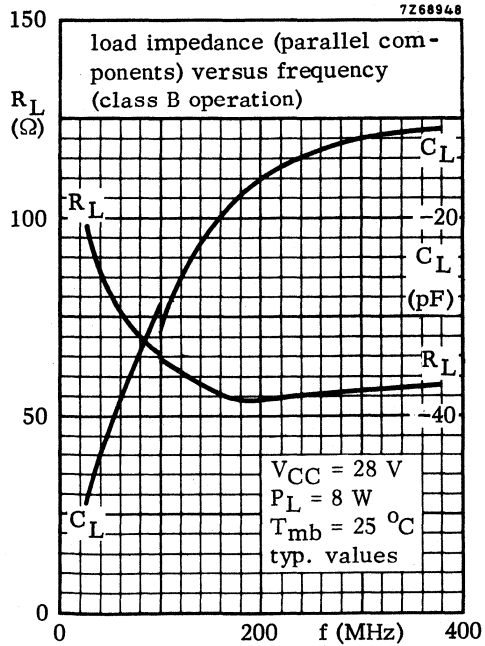
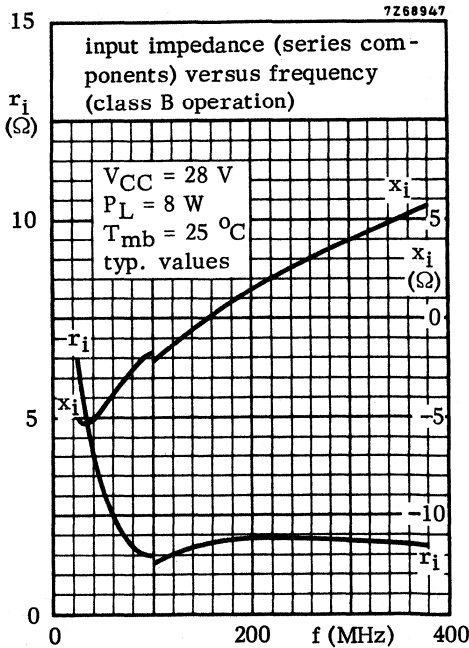
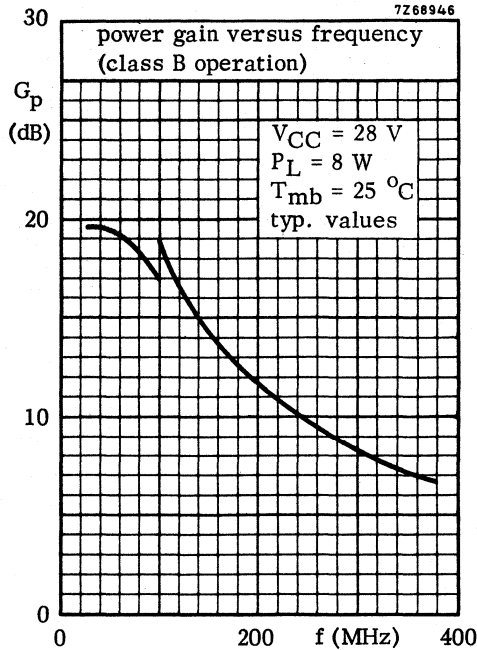


The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallised to serve as earth. Earth connections are made by means of hollow rivets.



For high voltage operation, a stabilized power supply is generally used. The graph shows the allowable output power under nominal conditions as a function of the V.S.W.R., with heat-sink temperature as parameter.

**OPERATING NOTE** Below 100 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated h.f. and v.h.f. transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

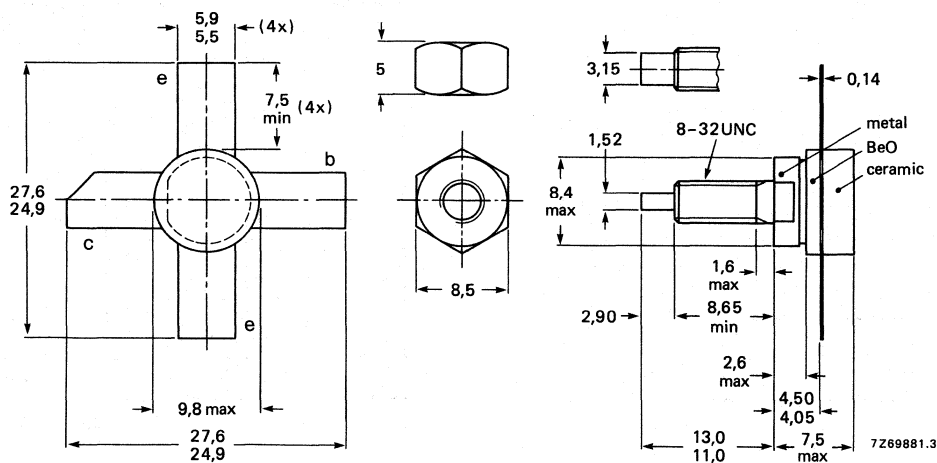
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit.

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	8	> 12	> 65	$1,8 + j0,7$	$18 - j20$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	0,9 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	2,5 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	20 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

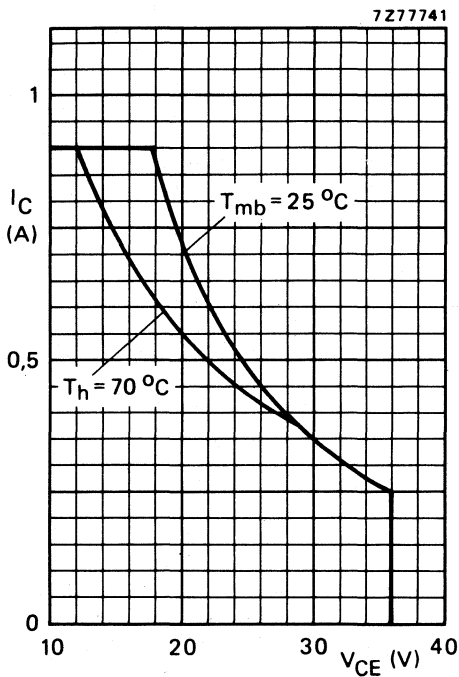


Fig. 2 D.C. SOAR.

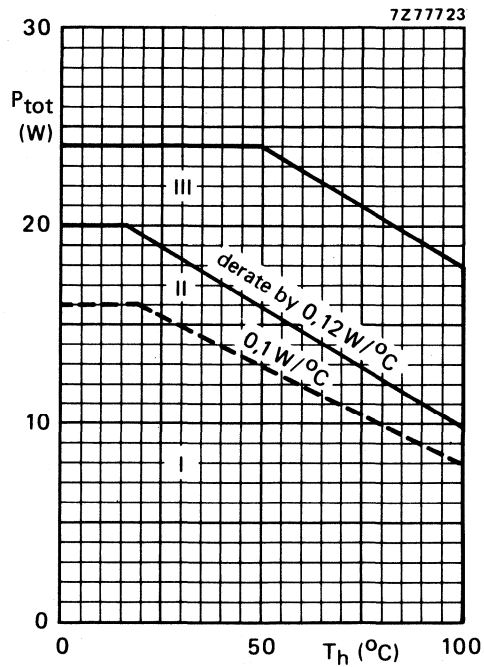


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  
 $f > 1$  MHz.  
I Continuous d.c operation  
II Continuous r.f. operation  
III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 8 W;  $T_{mb} = 73,6$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th j-mb(dc)}$	=	10,7 K/W
From junction to mounting base (r.f. dissipation)	$R_{th j-mb(rf)}$	=	8,6 K/W
From mounting base to heatsink	$R_{th mb-h}$	=	0,45 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 2\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 10\text{ mA}$  $V_{(BR)CEO} > 36\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 1\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 36\text{ V}$  $I_{CES} < 1\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\text{ }\Omega$  $E_{SBO} > 0,5\text{ mJ}$  $E_{SBR} > 0,5\text{ mJ}$ 

D.C. current gain\*

 $I_C = 0,4\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 50  
10 to 100

Collector-emitter saturation voltage\*

 $I_C = 1,25\text{ A}; I_B = 0,25\text{ A}$  $V_{CEsat}$  typ. 0,8 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 0,4\text{ A}; V_{CB} = 28\text{ V}$  $-I_E = 1,25\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 600 MHz $f_T$  typ. 525 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_c$  typ. 10 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 50\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re}$  typ. 7,1 pF

Collector-stud capacitance

 $C_{cs}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

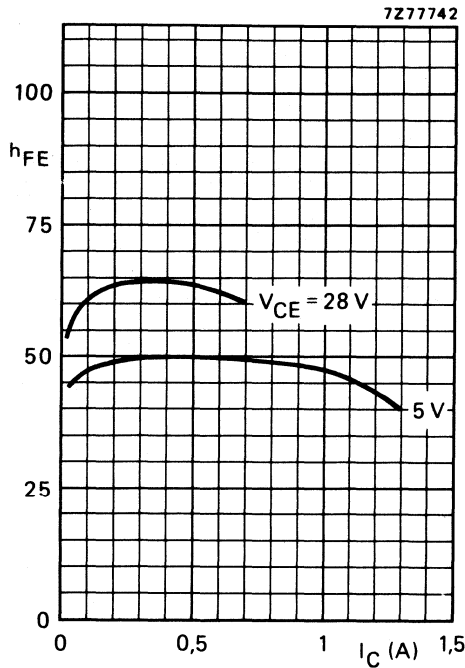


Fig. 4 Typical values;  $T_j = 25^\circ\text{C}$ .

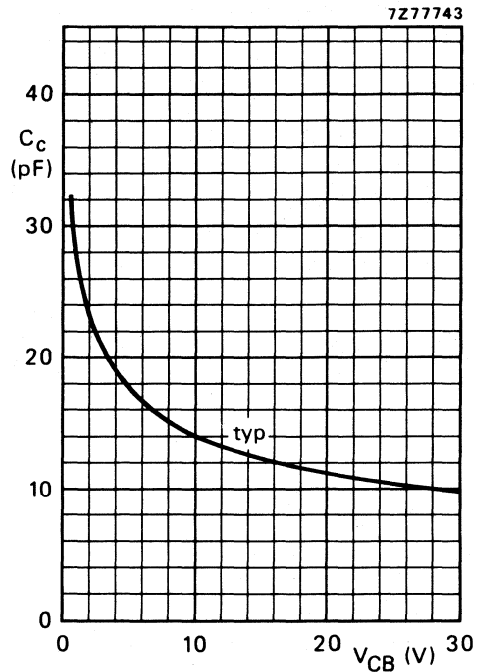


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

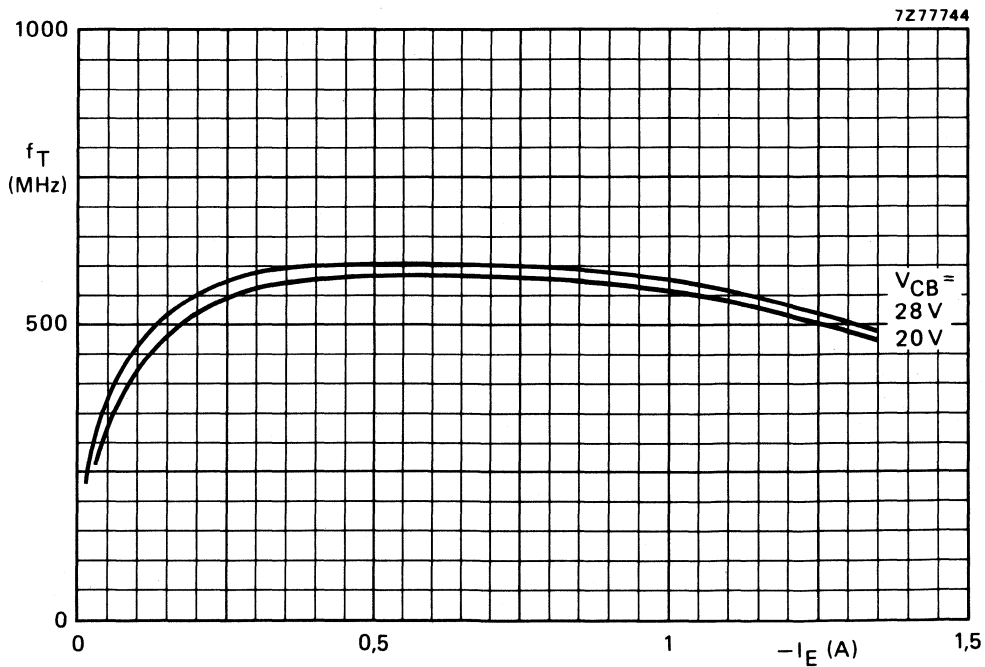


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	28	8	<0,5	> 12	<0,44	> 65	$1,8 + j0,7$	$18 - j20$

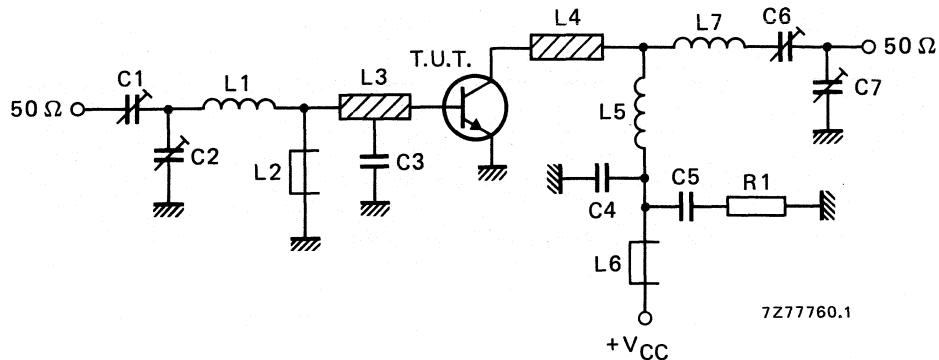


Fig. 7 Test circuit; c.w. class-B.

List of components:

C1 = C7 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3 = 27 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

L1 = 1 turn Cu wire (1,6 mm); int. dia. 8,4 mm; leads 2 x 5 mm

L2 = 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

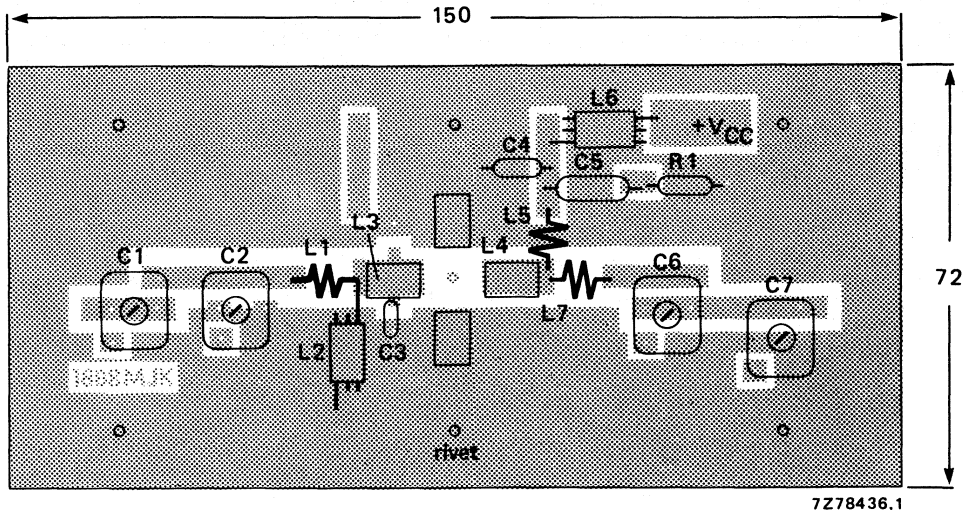
L6 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L7 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 8,2 mm; leads 2 x 5 mm

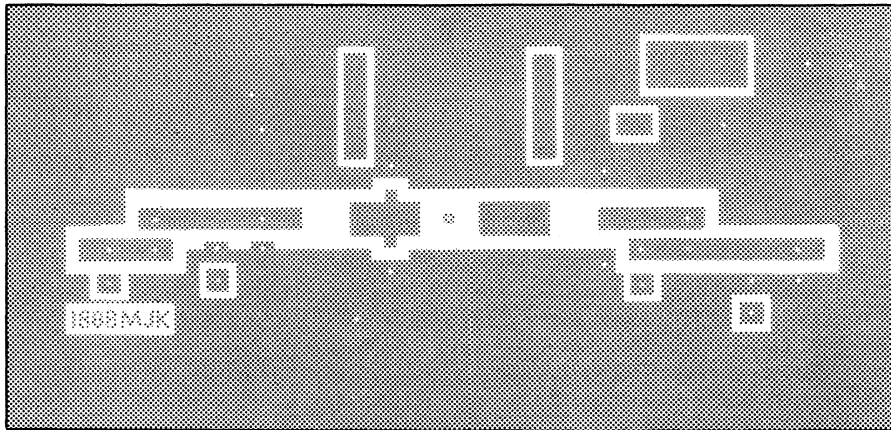
L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.



7Z78436.1



7Z78435

Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

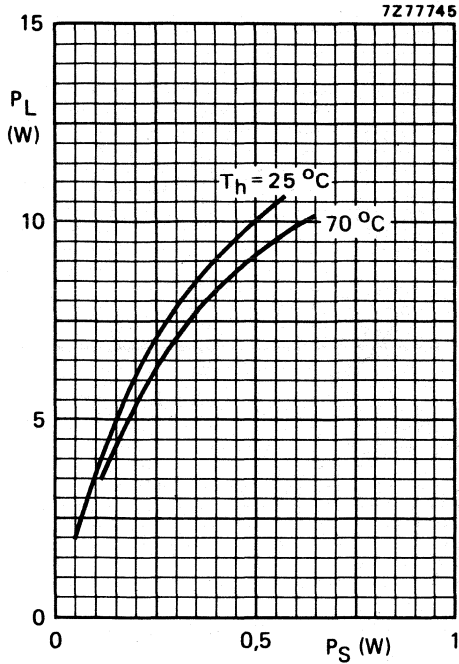


Fig. 9 Typical values;  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ .

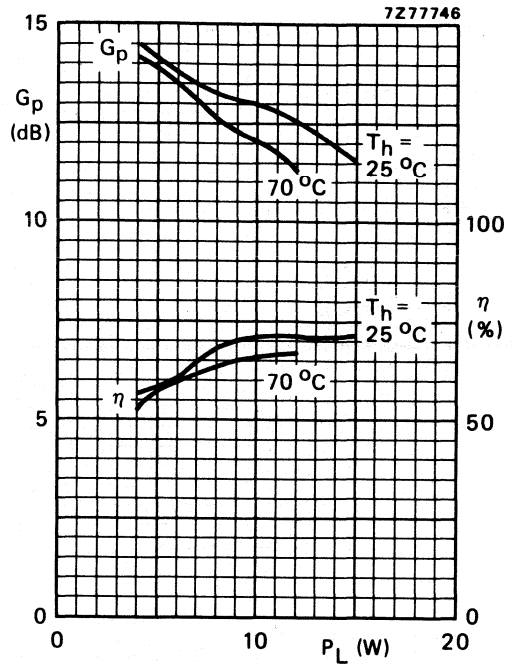


Fig. 10 Typical values;  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ .

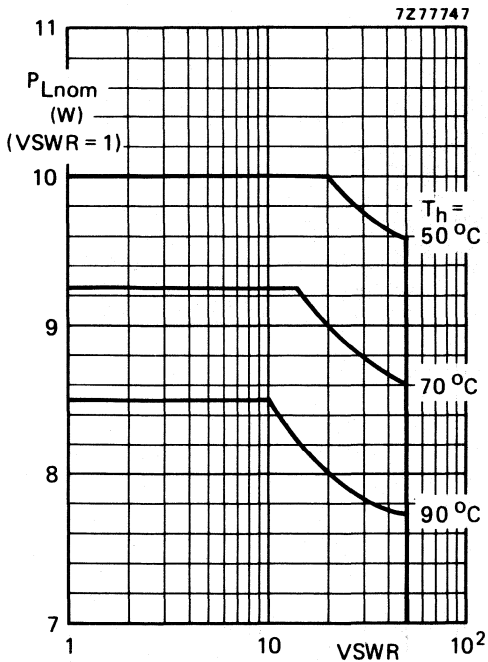


Fig. 11 R.F. SOAR; c.w. class-B operation;  $f = 175\text{ MHz}$ ;  $V_{CE} = 28\text{ V}$ ;  $R_{th\text{ mb-h}} = 0,45\text{ K/W}$ . The graph shows the permissible output power under nominal conditions (VSWR = 1) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

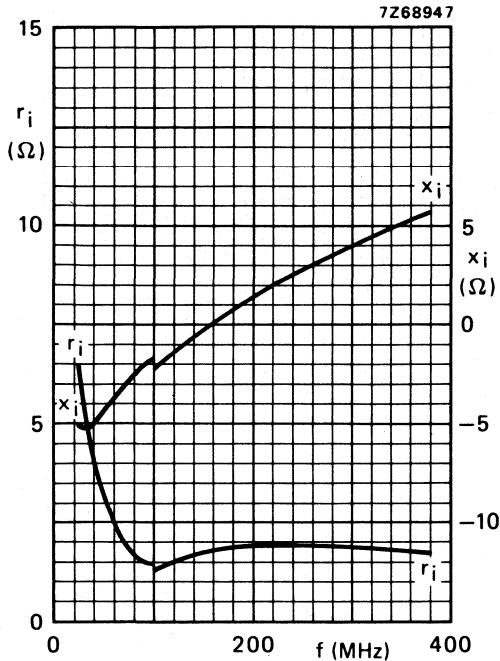


Fig. 12 Input impedance (series components).

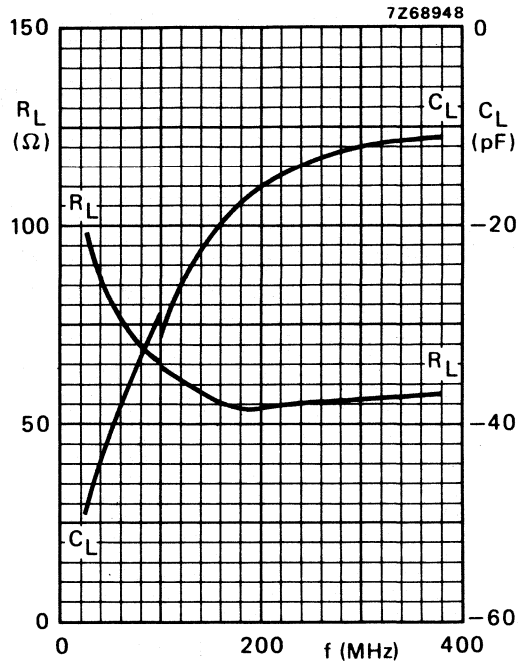


Fig. 13 Load impedance (parallel components).

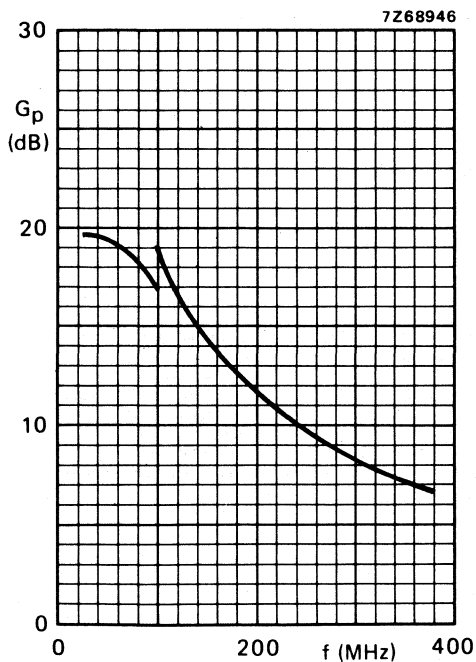


Fig. 14.

Conditions for Figs 12, 13 and 14.

Typical values;  $V_{CE} = 28$  V;  $P_L = 8$  W;

$T_h = 25$  °C.

**OPERATING NOTE**

Below 100 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.



### V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor for use in class-A, B and C operated mobile, industrial and military transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

It has a ¼" capstan envelope with a moulded cap. All leads are isolated from the stud.

#### QUICK REFERENCE DATA

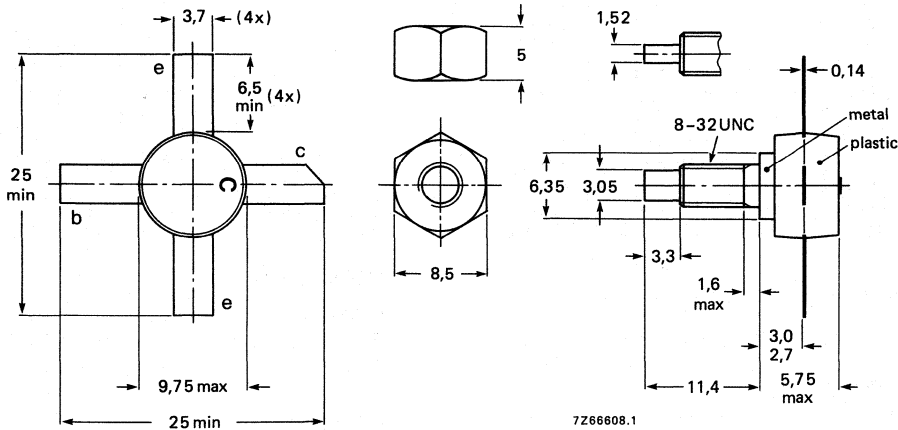
R.F. performance up to  $T_{mb} = 25 \text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

Mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	15	> 10	> 65	$1,4 + j1,85$	$33 - j27,5$

#### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-48/2.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)  
peak value

$V_{CBOM}$  max. 65 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 36 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

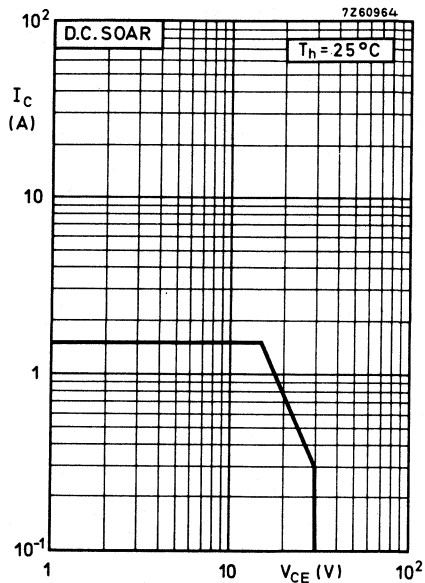
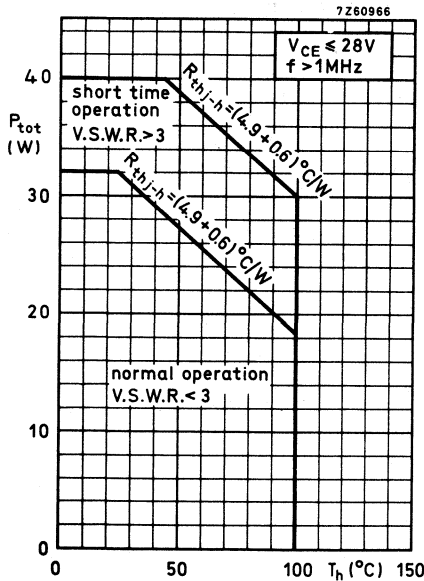
$I_{C(AV)}$  max. 1.5 A

Collector current (peak value)  $f > 1$  MHz

$I_{CM}$  max. 4.5 A

Total power dissipation up to  $T_h = 25^\circ\text{C}$   
 $f > 1$  MHz

$P_{tot}$  max. 32 W



Storage temperature

$T_{stg}$  -30 to +200 °C

Operating junction temperature

$T_j$  max. 200 °C

**THERMAL RESISTANCE**

From junction to mounting base

$R_{th j-mb} = 4.9$  K/W

From mounting base to heatsink

$R_{th mb-h} = 0.6$  K/W

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Collector cut-off current

$I_B = 0; V_{CE} = 28\text{ V}$   $I_{CEO} < 10\text{ mA}$

Breakdown voltages

Collector-base voltage

open emitter,  $I_C = 3\text{ mA}$   $V_{(BR)CBO} > 65\text{ V}$

Collector-emitter voltage

open base,  $I_C = 25\text{ mA}$   $V_{(BR)CEO} > 36\text{ V}$

Emitter-base voltage

open collector;  $I_E = 3\text{ mA}$   $V_{(BR)EBO} > 4\text{ V}$

Transient energy

$L = 25\text{ mH}; f = 50\text{ Hz}$

open base  $E > 2.0\text{ ms}$

$-V_{BE} = 1.5\text{ V}; R_{BE} = 33\text{ }\Omega$   $E > 4.5\text{ ms}$

D. C. current gain

$I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$   $h_{FE} > 5$

Transition frequency

$I_C = 600\text{ mA}; V_{CE} = 20\text{ V}$   $f_T$  typ. 500 MHz

Collector capacitance at  $f = 1\text{ MHz}$

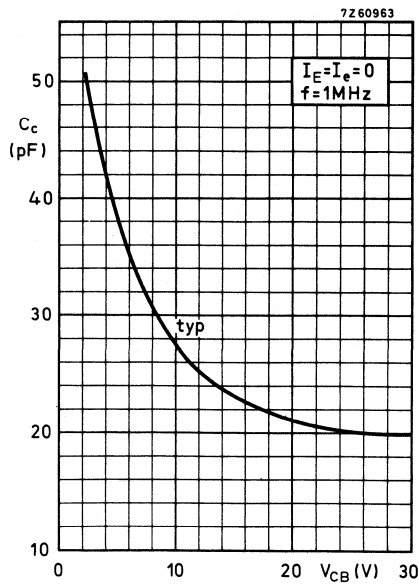
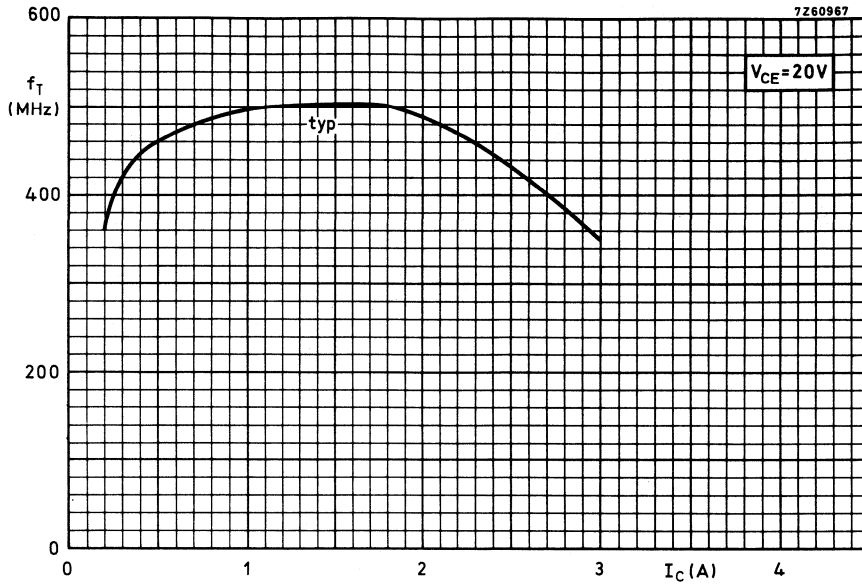
$I_E = I_e = 0; V_{CB} = 30\text{ V}$   $C_c$  typ. 20 pF  
< 30 pF

Feedback capacitance at  $f = 1\text{ MHz}$

$I_C = 100\text{ mA}; V_{CE} = 30\text{ V}$   $C_{re}$  typ. 15 pF

Collector-stud capacitance

$C_{cs}$  typ. 2 pF



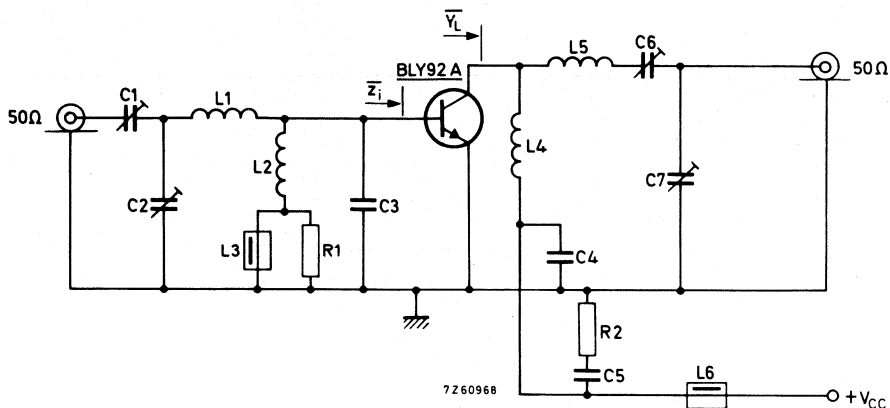
## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $V_{CE} = 28 \text{ V}$ ;  $T_{mb}$  up to  $25 \text{ }^\circ\text{C}$ 

f (MHz)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{V}_L$ (mS)
175	< 1,5	15	< 0,83	> 10	> 65	$1,4 + j1,85$	$33 - j27,5$

Test circuit: 175 MHz; c.w. class-B.



C1 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = C7 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

C3 = 47 pF ceramic capacitor

C4 = 100 pF ceramic capacitor

C5 = 150 nF polyester capacitor

L1 = 0,5 turn enamelled Cu wire (1,6 mm); int. dia. 6 mm; leads 2 x 10 mm

L2 = 6,5 turns closely wound enamelled Cu wire (0,7 mm); int. dia. 4 mm; leads 2 x 5 mm

L3 = L5 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

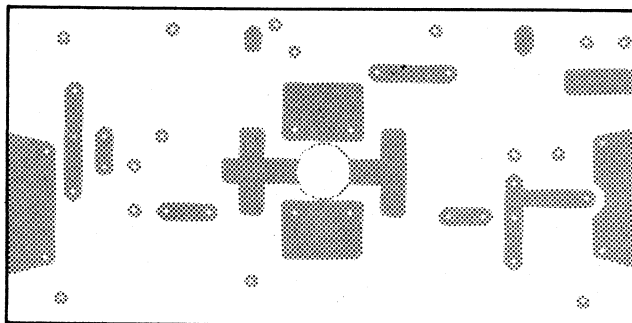
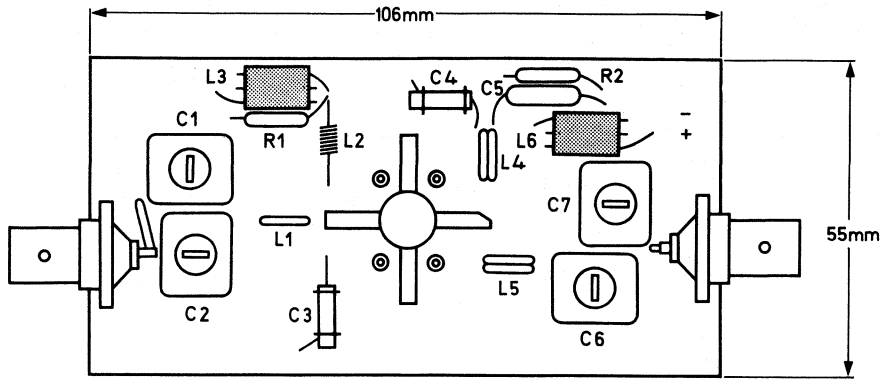
L4 = 2,5 turns enamelled Cu wire (0,7 mm); int. dia. 6 mm; leads 2 x 7 mm

L6 = 4,5 turns enamelled Cu wire (0,7 mm); int. dia. 6 mm; leads 2 x 7 mm

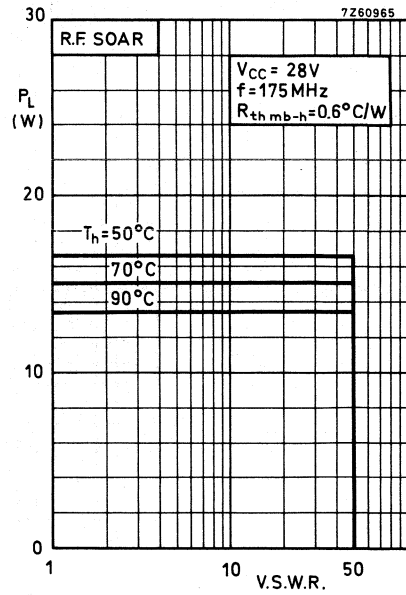
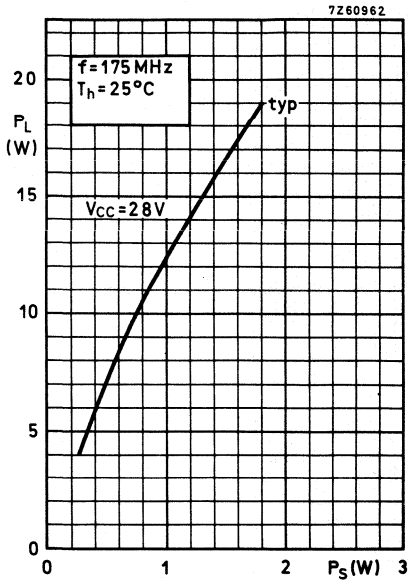
R1 = R2 = 10  $\Omega$  carbon resistor

APPLICATION INFORMATION (continued)

Component lay-out and printed circuit board for 175 MHz test circuit.

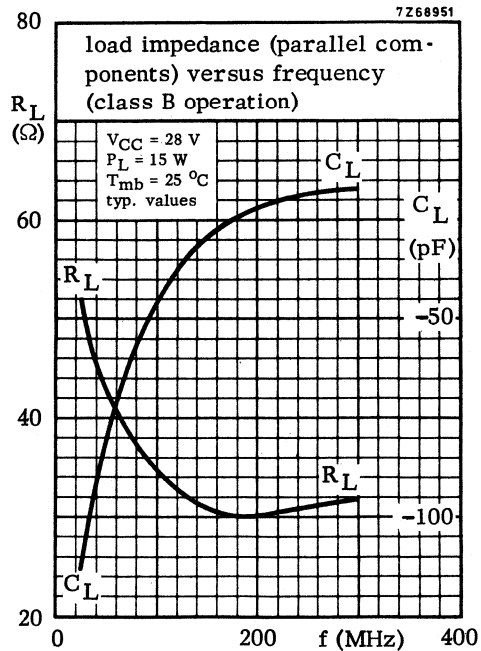
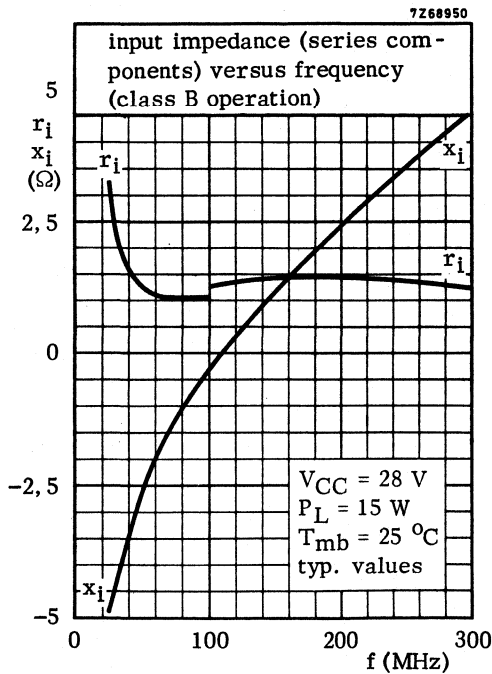
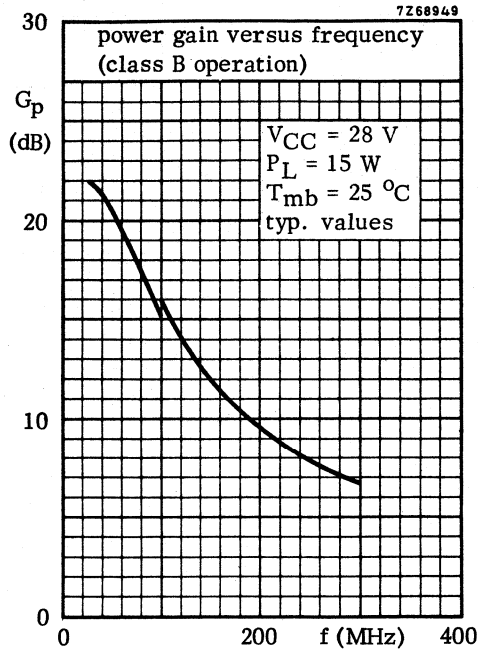


The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallised to serve as earth. Earth connections are made by means of hollow rivets.



For high voltage operation, a stabilized power supply is generally used. The graph shows the allowable output power under nominal conditions as a function of the V.S.W.R., with heat-sink temperature as parameter.

**OPERATING NOTE** Below 100 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.





## V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for use in class-A, B and C operated h.f. and v.h.f. transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions.

It has a 3/8" capstan envelope with a ceramic cap. All leads are isolated from the stud.

### QUICK REFERENCE DATA

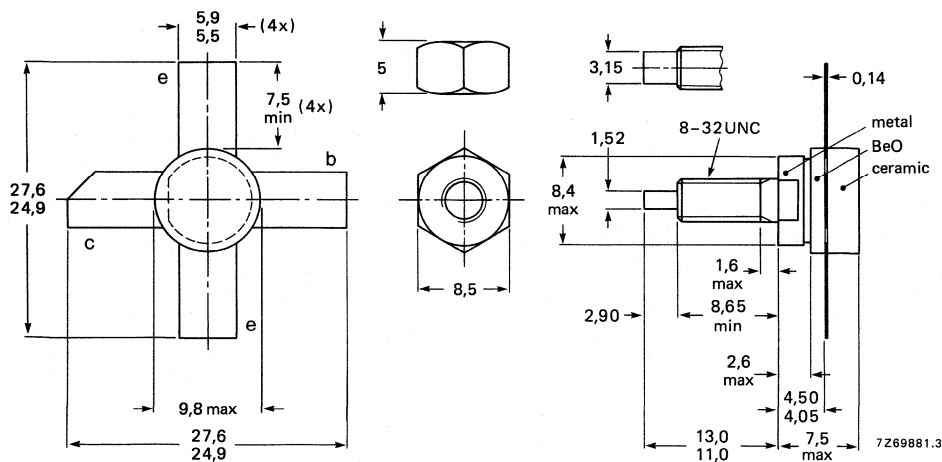
R.F. performance up to  $T_h = 25\text{ }^\circ\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_L$ W	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	15	> 10	> 65	$1,4 + j1,85$	$33 - j27,5$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-120.



Torque on nut: min. 0,75 Nm  
(7,5 kg cm)  
max. 0,85 Nm  
(8,5 kg cm)

Diameter of clearance hole in heatsink: max. 4,2 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or  
countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_C(AV)$	max.	1,75 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	5,0 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	36 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

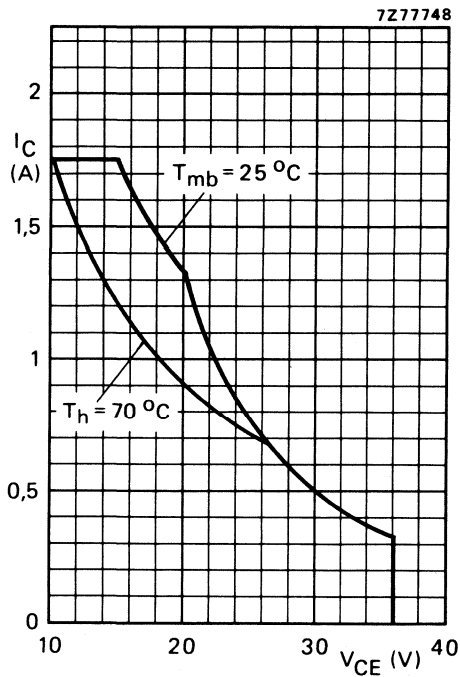


Fig. 2 D.C. SOAR.

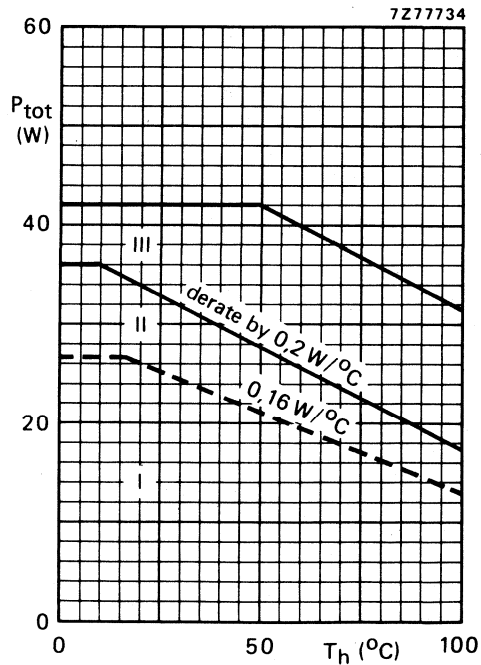


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f > 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 15 W;  $T_{mb} = 77$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb(dc)}$	=	6,55 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb(rf)}$	=	4,95 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,45 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 5\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 25\text{ mA}$  $V_{(BR)CEO} > 36\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 2\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 36\text{ V}$  $I_{CES} < 2\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $E_{SBO} > 2,5\text{ mJ}$  $R_{BE} = 10\text{ }\Omega$  $E_{SBR} > 2,5\text{ mJ}$ 

D.C. current gain\*

 $I_C = 0,7\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 50  
10 to 100

Collector-emitter saturation voltage\*

 $I_C = 2\text{ A}; I_B = 0,4\text{ A}$  $V_{CEsat}$  typ. 0,65 VTransition frequency at  $f = 100\text{ MHz}$ \* $-I_E = 0,7\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 650 MHz $-I_E = 2\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 625 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_C$  typ. 18 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re}$  typ. 12,8 pF

Collector-stud capacitance

 $C_{cs}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

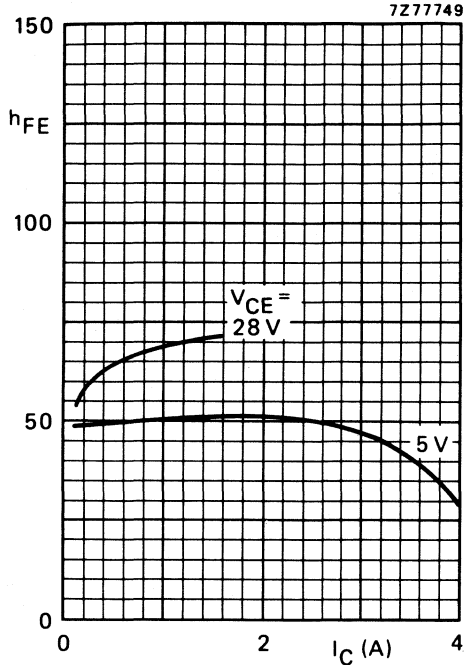


Fig. 4 Typical values;  $T_j = 25^\circ\text{C}$ .

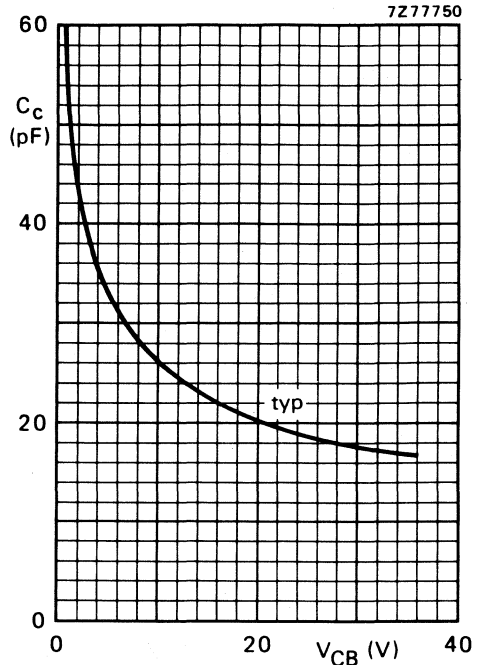


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

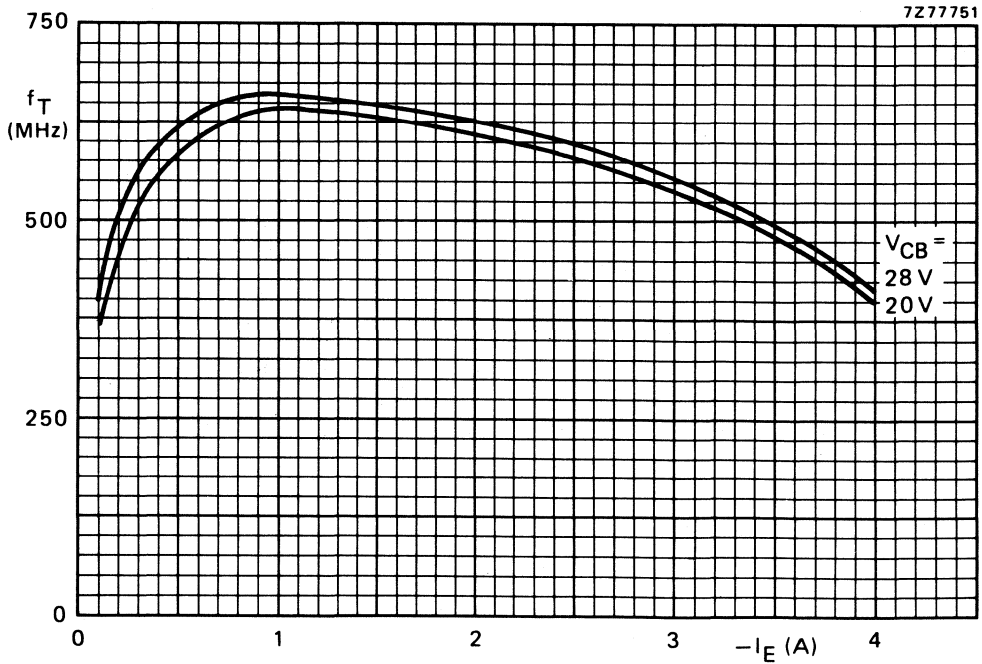


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25\text{ }^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	28	15	< 1,5	> 10	< 0,83	> 65	$1,4 + j1,85$	$33 - j27,5$

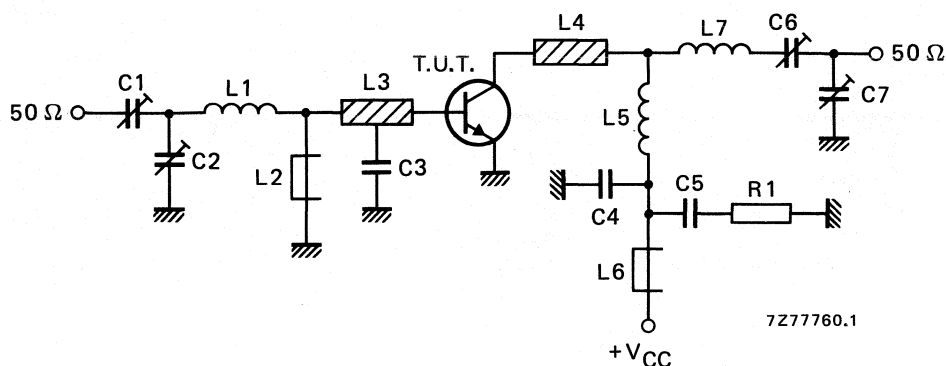


Fig. 7 Test circuit; c.w. class-B.

## List of components:

C1 = C7 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = C6 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3 = 27 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor (500 V)

C5 = 100 nF polyester capacitor

L1 = 1 turn Cu wire (1,6 mm); int. dia. 8,4 mm; leads 2 x 5 mm

L2 = 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); tap for C3 at 5 mm from transistor

L6 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 9,0 mm; leads 2 x 5 mm

L7 = 3 turns closely wound enamelled Cu wire (1,0 mm); int. dia. 8,2 mm; leads 2 x 5 mm

L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.

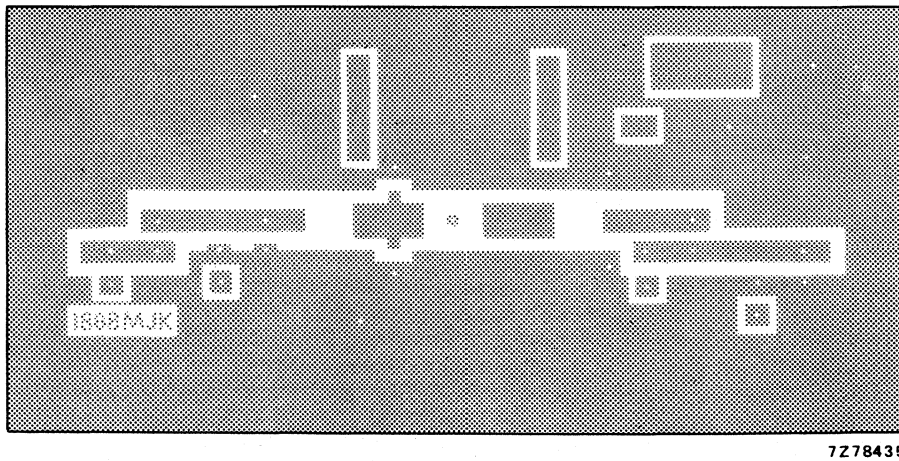
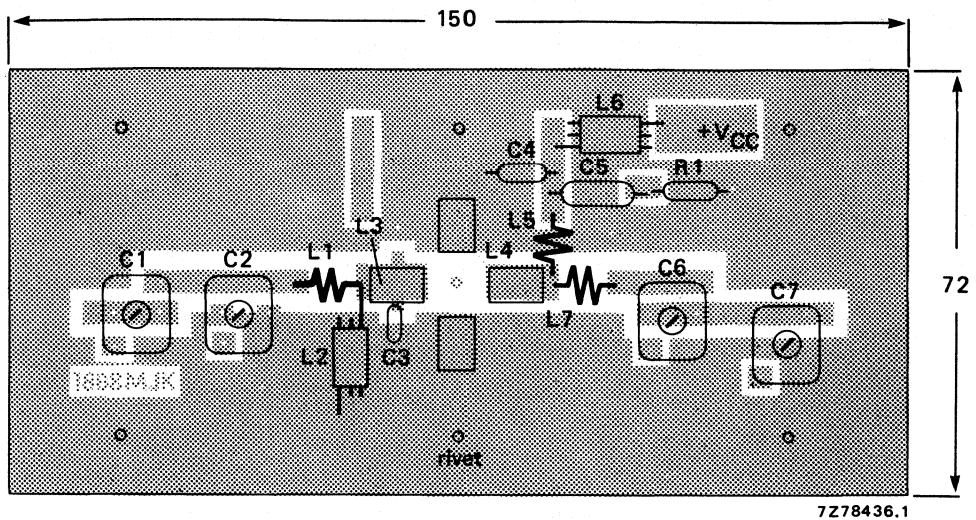


Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

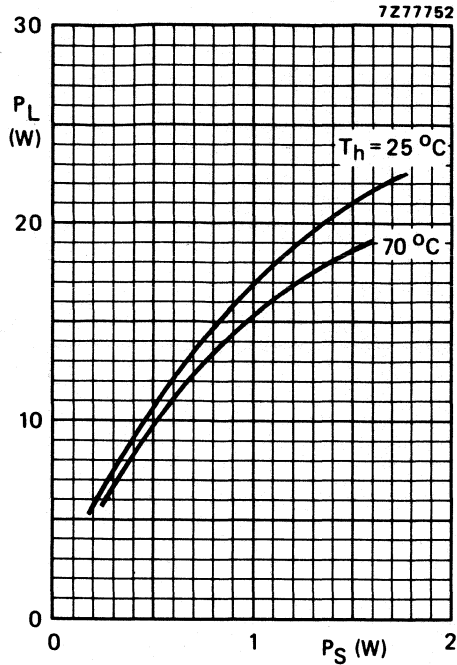


Fig. 9 Typical values;  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ .

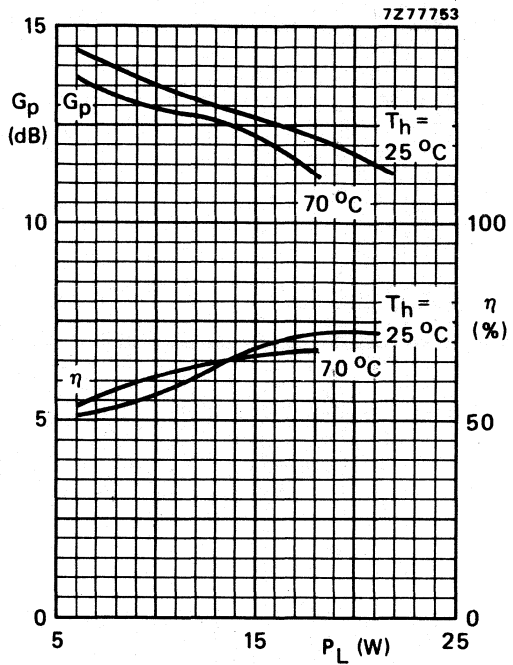


Fig. 10 Typical values;  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ .

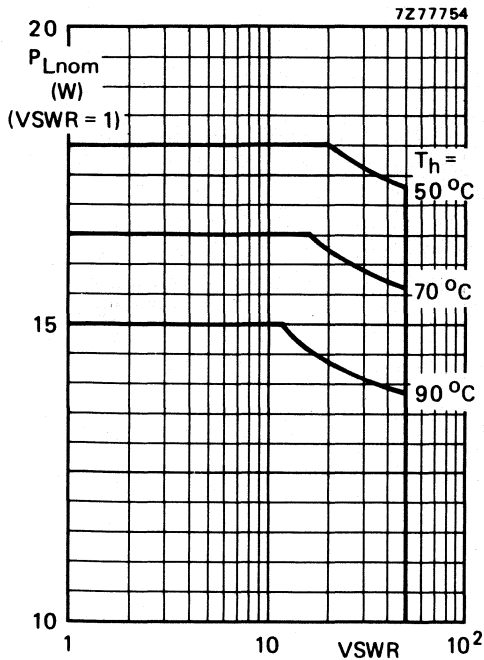


Fig. 11 R.F. SOAR; c.w. class-B operation;  $f = 175\text{ MHz}$ ;  $V_{CE} = 28\text{ V}$ ;  $R_{th\text{ mb-h}} = 0,45\text{ K/W}$ . The graph shows the permissible output power under nominal conditions (VSWR = 1) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

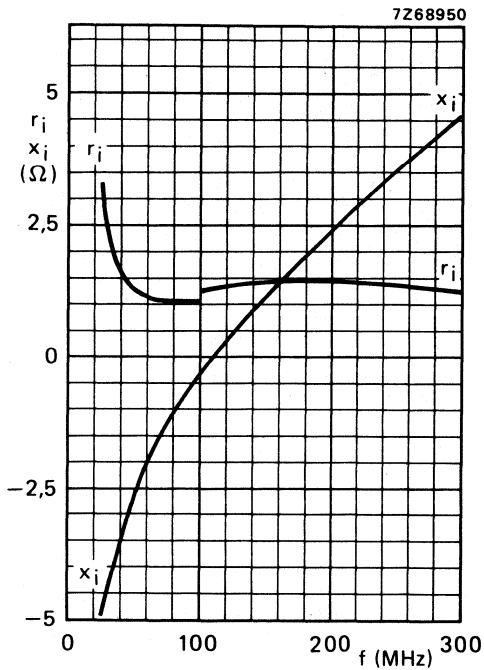


Fig. 12 Input impedance (series components).

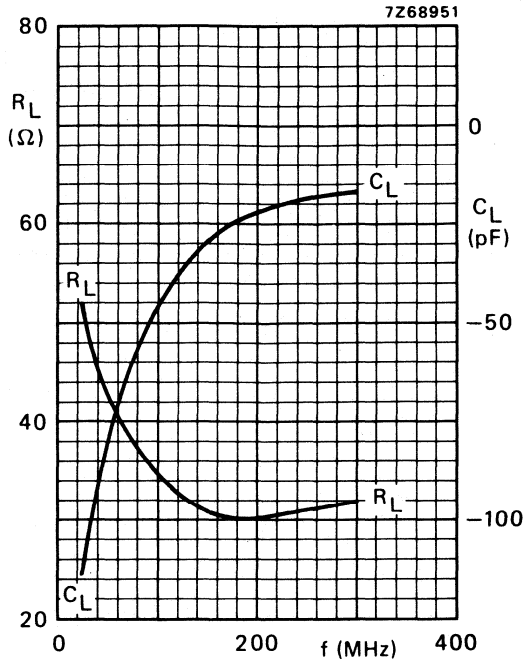


Fig. 13 Load impedance (parallel components).

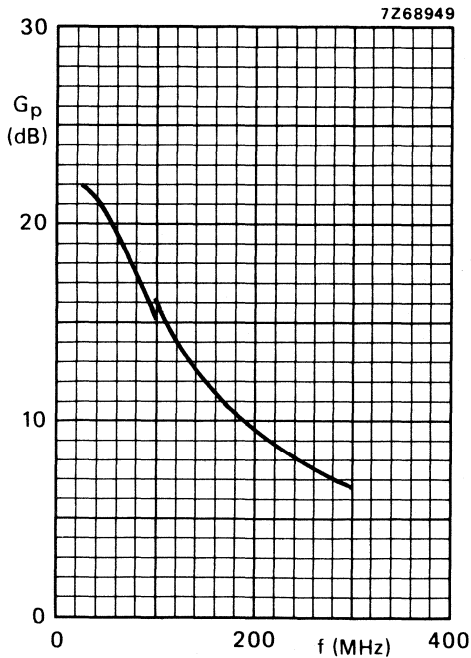


Fig. 14.

Conditions for Figs 12, 13 and 14.

Typical values;  $V_{CE} = 28$  V;  $P_L = 15$  W;

$T_h = 25$  °C.

**OPERATING NOTE**

Below 100 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation.. This resistor must be effective for r.f. only.



### V.H.F. POWER TRANSISTOR

N-P-N epitaxial planar transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 28 V. The transistor is resistance stabilized. Every transistor is tested under severe load mismatch conditions. It has a 1/4" capstan envelope with a moulded cap. All leads are isolated from the stud.

#### QUICK REFERENCE DATA

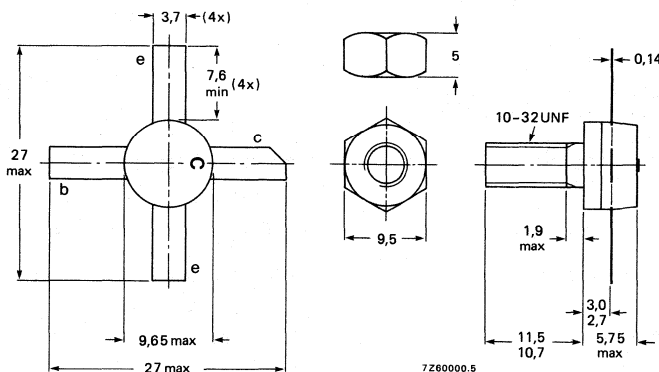
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_D$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	< 3,1	25	< 1,5	> 9	> 60	$1,0 + j1,2$	$58,8 - j53,8$

#### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-56.



Torque on nut: min. 1,5 Nm  
(15 kg cm)  
max. 1,7 Nm  
(17 kg cm)

Diameter of clearance hole in heatsink: max. 4,9 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC134)

Collector-base voltage (open emitter)  
peak value

$V_{CBOM}$  max. 65 V

Collector-emitter voltage (open base)

$V_{CEO}$  max. 36 V

Emitter-base voltage (open collector)

$V_{EBO}$  max. 4 V

Collector current (average)

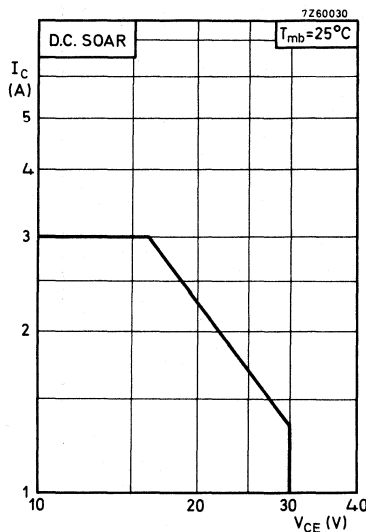
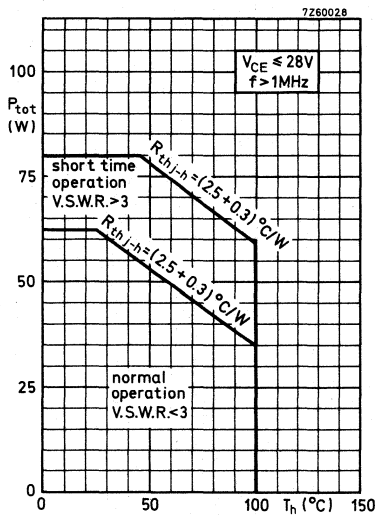
$I_{C(AV)}$  max. 3 A

Collector current (peak value)  $f > 1$  MHz

$I_{CM}$  max. 9 A

Total power dissipation up to  $T_{mb} = 25$  °C  
 $f > 1$  MHz

$P_{tot}$  max. 70 W



Storage temperature

$T_{stg}$  -30 to +200 °C

Operating junction temperature

$T_j$  max. 200 °C

**THERMAL RESISTANCE**

From junction to mounting base

$R_{th j-mb} = 2.5$  K/W

From mounting base to heatsink

$R_{th mb-h} = 0.3$  K/W

## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage

open emitter,  $I_C = 50\text{ mA}$

$V_{(BR)CBO} > 65\text{ V}$

Collector-emitter voltage

open base,  $I_C = 50\text{ mA}$

$V_{(BR)CEO} > 36\text{ V}$

Emitter-base voltage

open collector;  $I_E = 10\text{ mA}$

$V_{(BR)EBO} > 4\text{ V}$

## Transient energy

$L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$

open base

$E > 8\text{ ms}$

$-V_{BE} = 1.5\text{ V}$ ;  $R_{BE} = 33\ \Omega$

$E > 8\text{ ms}$

## D. C. current gain

$I_C = 1\text{ A}$ ;  $V_{CE} = 5\text{ V}$

$h_{FE}$  typ. 50  
10 to 120

## Transition frequency

$I_C = 3\text{ A}$ ;  $V_{CE} = 20\text{ V}$

$f_T$  typ. 500 MHz

Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0$ ;  $V_{CB} = 30\text{ V}$

$C_c$  typ. 50 pF  
< 65 pF

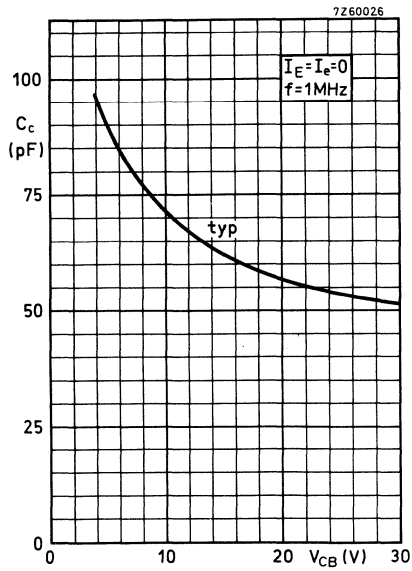
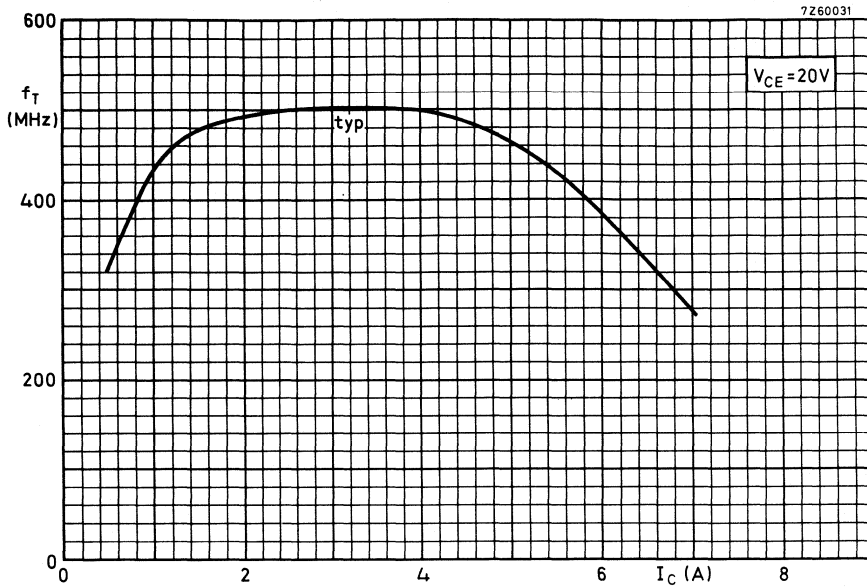
Feedback capacitance at  $f = 1\text{ MHz}$ 

$I_C = 100\text{ mA}$ ;  $V_{CE} = 30\text{ V}$

$C_{re}$  typ. 31 pF

## Collector-stud capacitance

$C_{cs}$  typ. 2 pF



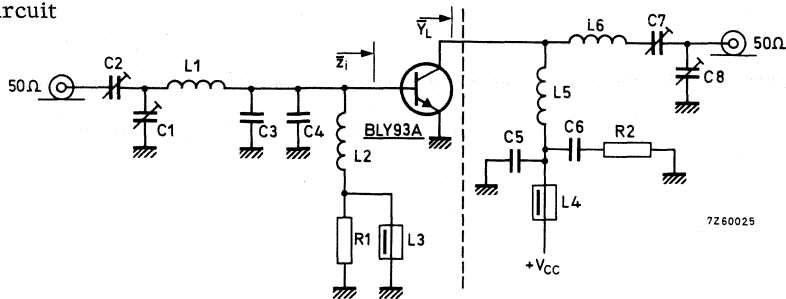
## APPLICATION INFORMATION

R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

$$V_{CC} = 28 \text{ V}; T_{mb} = 25 \text{ }^{\circ}\text{C}$$

f(MHz)	P <sub>S</sub> (W)	P <sub>L</sub> (W)	I <sub>C</sub> (A)	G <sub>p</sub> (dB)	η (%)	Z <sub>i</sub> (Ω)	Y <sub>L</sub> (mS)
175	< 3.1	25	< 1.5	> 9	> 60	1.0 + j1.2	58.8 - j53.8

Test circuit



C1 = 4 to 44 pF film dielectric trimmer (code number 2222 809 07008)

C2 = 2 to 22 pF film dielectric trimmer (code number 2222 809 07004)

C3 = C4 = 47 pF ceramic

C5 = 100 pF ceramic

C6 = 150 nF polyester

C7 = 4 to 104 pF film dielectric trimmer (code number 2222 809 07015)

C8 = 4 to 64 pF film dielectric trimmer (code number 2222 809 07011)

L1 = 0.5 turn enamelled Cu wire (1.5 mm); int.diam. 6 mm; leads 2 x 6 mm

L2 = 6 turns closely wound enamelled Cu wire (0.7 mm); int.diam. 4 mm;  
leads 2 x 4 mm

L3 = L4 = ferroxcube choke (code number 4312 020 36640)

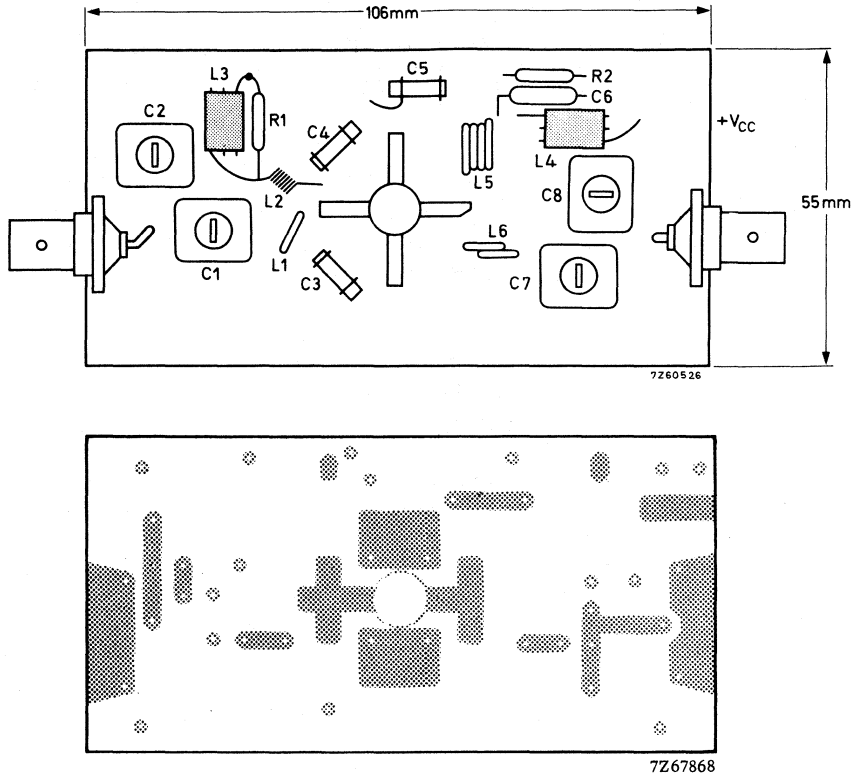
L5 = 3.5 turns enamelled Cu wire (1.5 mm); int.diam. 6 mm; leads 2 x 6 mm

L6 = 1.5 turns enamelled Cu wire (1.5 mm); int.diam. 6 mm; leads 2 x 6 mm

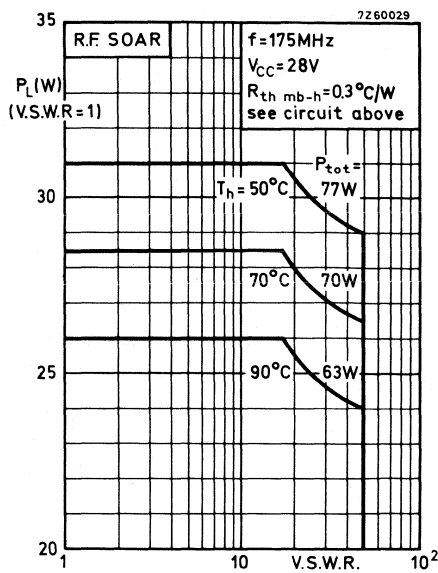
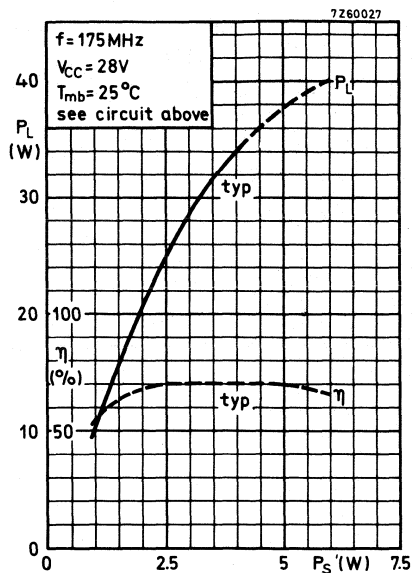
R1 = R2 = 10 Ω carbon

APPLICATION INFORMATION (continued)

Component lay-out and printed circuit board for 175 MHz test circuit.



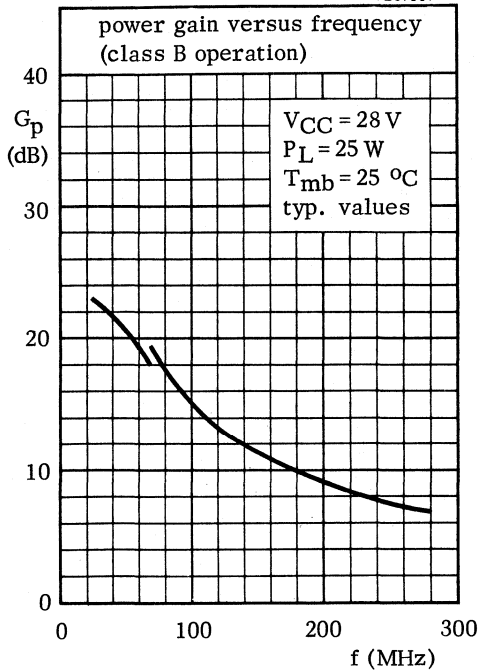
The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallised to serve as earth. Earth connections are made by means of hollow rivets.



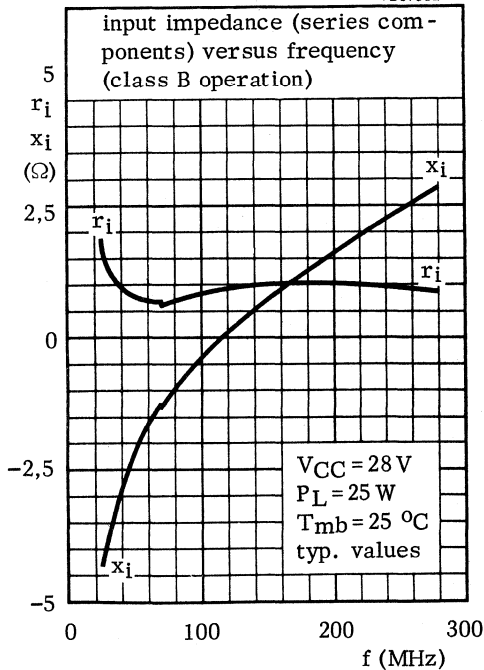
For high voltage operation, a stabilized power supply is generally used. The graph shows the allowable output power under nominal conditions as a function of the V.S.W.R., with heat-sink temperature as parameter.

**OPERATING NOTE** Below 70 MHz a base-emitter resistor of  $10\ \Omega$  is recommended to avoid oscillation. This resistor must be effective for both d.c. and r.f.

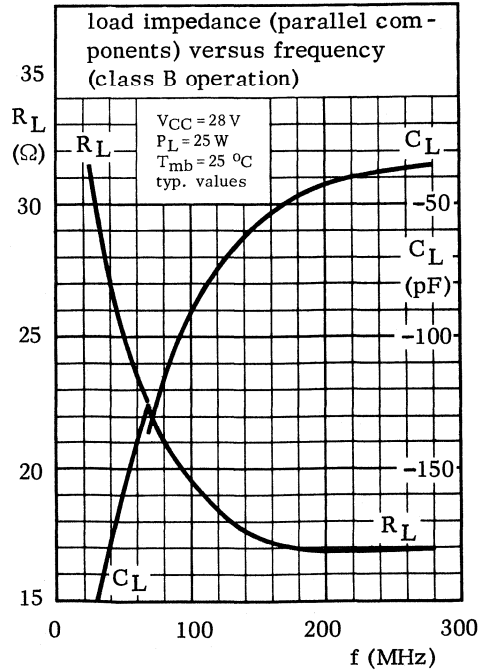
7Z67561



7Z67562



7Z67563







**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage ( $V_{BE} = 0$ ) peak value	$V_{CESM}$	max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	36 V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4 V
Collector current (average)	$I_{C(AV)}$	max.	3 A
Collector current (peak value); $f > 1$ MHz	$I_{CM}$	max.	9 A
R.F. power dissipation ( $f > 1$ MHz); $T_{mb} = 25$ °C	$P_{rf}$	max.	70 W
Storage temperature	$T_{stg}$		-65 to + 150 °C
Operating junction temperature	$T_j$	max.	200 °C

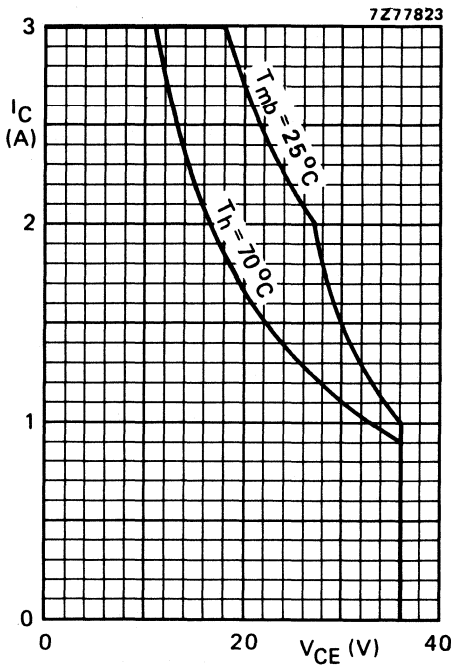


Fig. 2 D.C. SOAR.

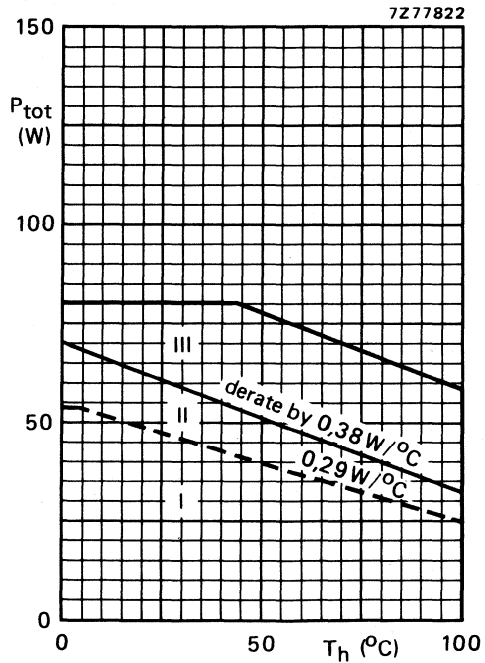


Fig. 3 R.F. power dissipation;  $V_{CE} \leq 28$  V;  $f \geq 1$  MHz.

- I Continuous d.c. operation
- II Continuous r.f. operation
- III Short-time operation during mismatch

**THERMAL RESISTANCE** (dissipation = 20 W;  $T_{mb} = 79$  °C, i.e.  $T_h = 70$  °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j-mb\ (dc)}$	=	3,1 K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j-mb\ (rf)}$	=	2,3 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0,45 K/W

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ 

Collector-emitter breakdown voltage

 $V_{BE} = 0; I_C = 10\text{ mA}$  $V_{(BR)CES} > 65\text{ V}$ 

Collector-emitter breakdown voltage

open base;  $I_C = 50\text{ mA}$  $V_{(BR)CEO} > 36\text{ V}$ 

Emitter-base breakdown voltage

open collector;  $I_E = 10\text{ mA}$  $V_{(BR)EBO} > 4\text{ V}$ 

Collector cut-off current

 $V_{BE} = 0; V_{CE} = 36\text{ V}$  $I_{CES} < 4\text{ mA}$ Second breakdown energy;  $L = 25\text{ mH}; f = 50\text{ Hz}$ 

open base

 $R_{BE} = 10\text{ }\Omega$  $E_{SBO} > 8\text{ mJ}$  $E_{SBR} > 8\text{ mJ}$ 

D.C. current gain \*

 $I_C = 1,25\text{ A}; V_{CE} = 5\text{ V}$  $h_{FE}$  typ. 45  
10 to 100

Collector-emitter saturation voltage \*

 $I_C = 3,75\text{ A}; I_B = 0,75\text{ A}$  $V_{CEsat}$  typ. 1,5 VTransition frequency at  $f = 100\text{ MHz}$  \* $-I_E = 1,25\text{ A}; V_{CB} = 28\text{ V}$  $-I_E = 3,75\text{ A}; V_{CB} = 28\text{ V}$  $f_T$  typ. 625 MHz $f_T$  typ. 625 MHzCollector capacitance at  $f = 1\text{ MHz}$  $I_E = I_e = 0; V_{CB} = 28\text{ V}$  $C_C$  typ. 45 pFFeedback capacitance at  $f = 1\text{ MHz}$  $I_C = 100\text{ mA}; V_{CE} = 28\text{ V}$  $C_{re}$  typ. 28 pF

Collector-stud capacitance

 $C_{cs}$  typ. 2 pF\* Measured under pulse conditions:  $t_p \leq 200\text{ }\mu\text{s}; \delta \leq 0,02$ .

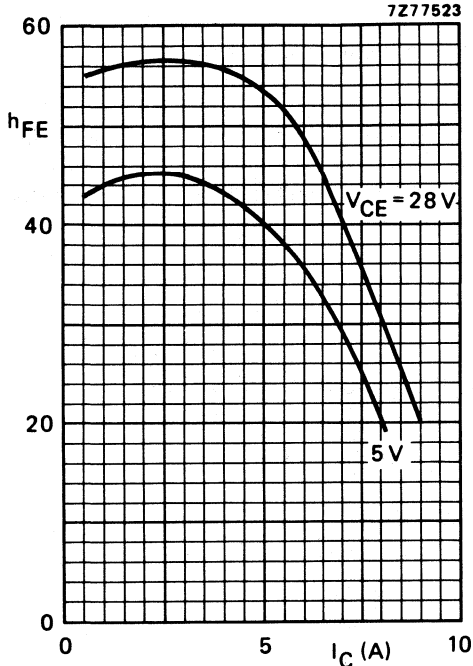


Fig. 4 Typical values;  $T_j = 25\text{ }^\circ\text{C}$ .

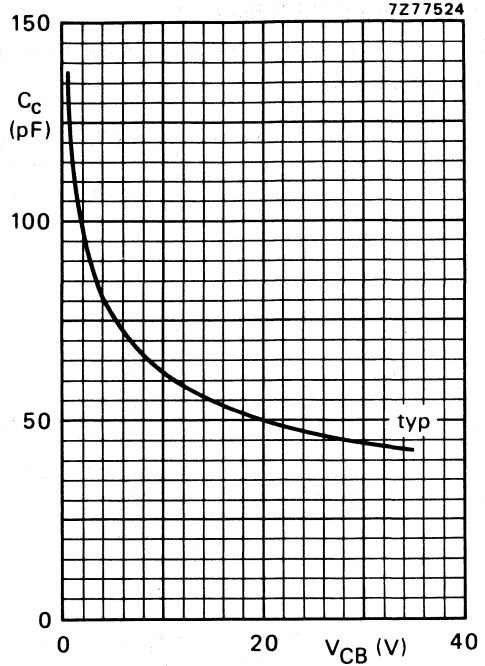


Fig. 5  $I_E = I_e = 0$ ;  $f = 1\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

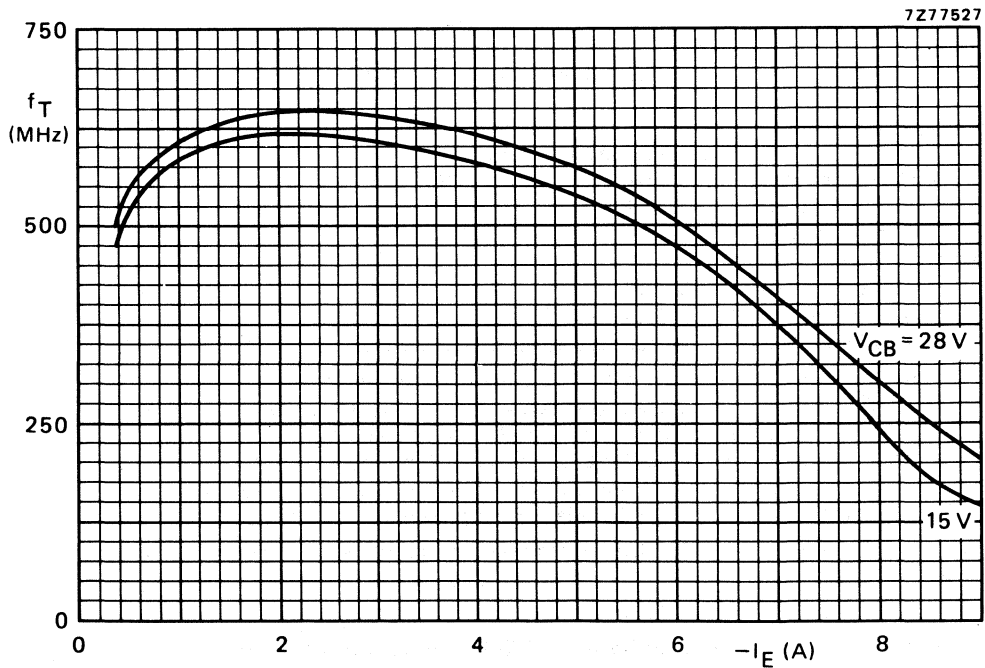


Fig. 6 Typical values;  $f = 100\text{ MHz}$ ;  $T_j = 25\text{ }^\circ\text{C}$ .

## APPLICATION INFORMATION

R.F. performance in c.w. operation (unneutralized common-emitter class-B circuit)

 $T_h = 25^\circ\text{C}$ 

f (MHz)	$V_{CE}$ (V)	$P_L$ (W)	$P_S$ (W)	$G_p$ (dB)	$I_C$ (A)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
175	28	25	< 3,15	> 9	< 1,5	> 60	$1,0 + j1,2$	$59 - j54$

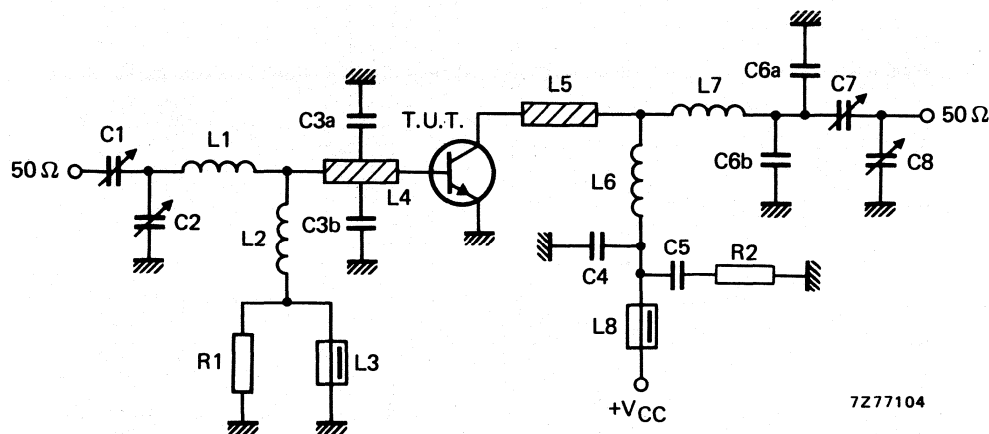


Fig. 7 Test circuit; c.w. class-B.

## List of components

C1 = C7 = 2,5 to 20 pF film dielectric trimmer (cat. no. 2222 809 07004)

C2 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)

C3a = C3b = 47 pF ceramic capacitor (500 V)

C4 = 120 pF ceramic capacitor

C5 = 100 nF polyester capacitor

C6a = 2,2 pF ceramic capacitor (500 V)

C6b = 1,8 pF ceramic capacitor (500 V)

C8 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)

L1 = 14 nH; 1 turn Cu wire (1,6 mm); int. dia. 7,7 mm; leads 2 x 5 mm

L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 5 mm

L3 = L8 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)

L4 = L5 = strip (12 mm x 6 mm); taps for C3a and C3b at 5 mm from transistor

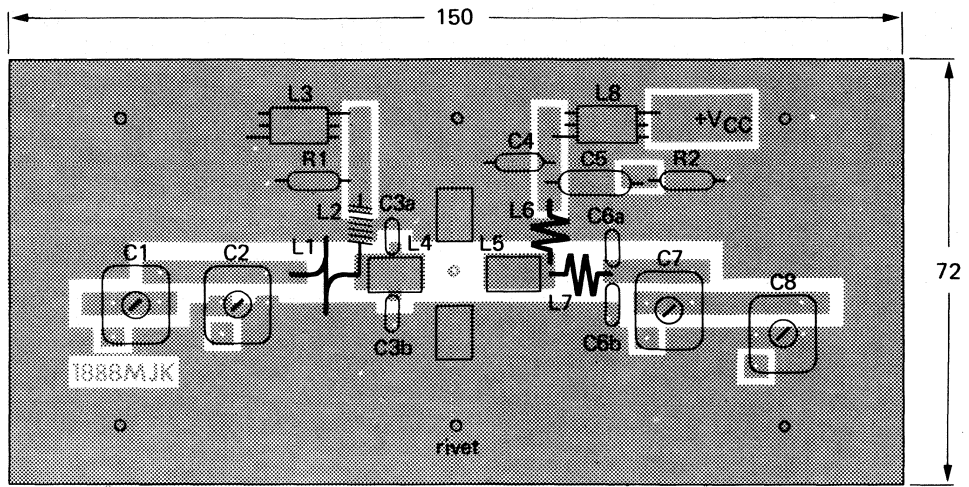
L6 = 80 nH; 3 turns Cu wire (1,6 mm); int. dia. 9,0 mm; length 8,0 mm; leads 2 x 5 mm

L7 = 62 nH; 3 turns Cu wire (1,6 mm); int. dia. 7,5 mm; length 8,1 mm; leads 2 x 5 mm

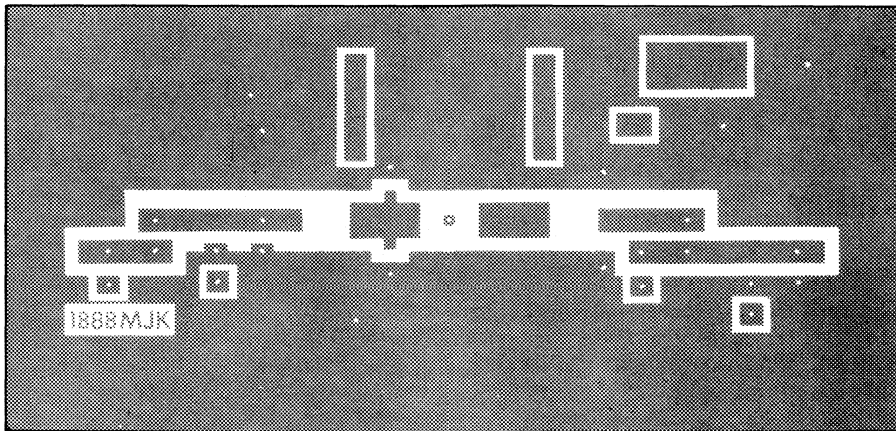
L4 and L5 are strips on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16".

R1 = R2 = 10  $\Omega$  carbon resistor (0,25 W)

Component layout and printed-circuit board for 175 MHz test circuit see Fig. 8.



7277102



7277103

Fig. 8 Component layout and printed-circuit board for 175 MHz test circuit.

The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallized to serve as earth. Earth connections are made by means of hollow rivets, whilst under the emitter leads Cu straps are used for a direct contact between upper and lower sheets.

To minimize the dielectric losses, the ground plane under the interconnection of L7 and C7 has been removed.

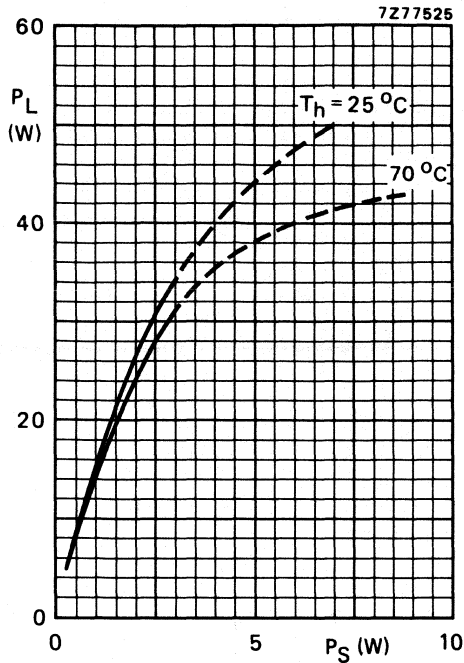


Fig. 9  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ ; typical values.

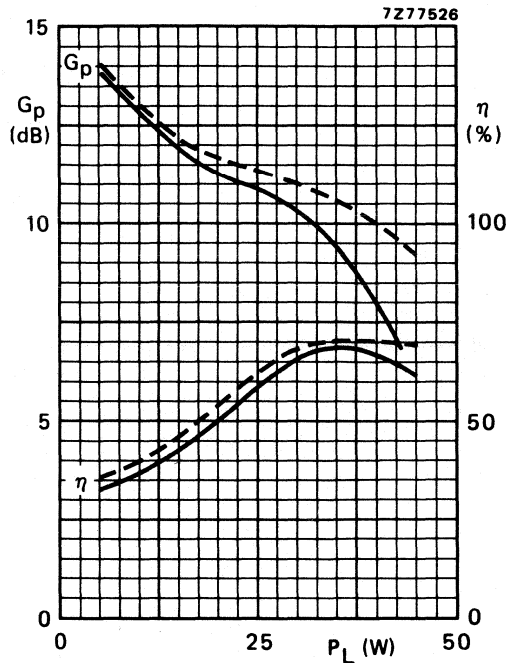


Fig. 10  $V_{CE} = 28\text{ V}$ ;  $f = 175\text{ MHz}$ ; typical values; ---  $T_h = 25^\circ\text{C}$ ; —  $T_h = 70^\circ\text{C}$ .

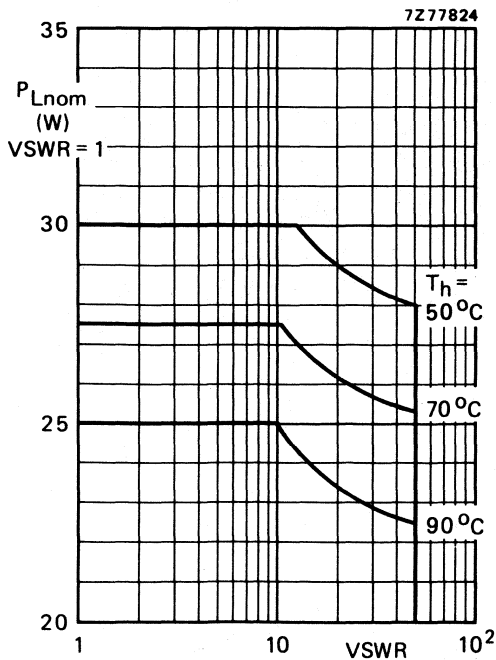


Fig. 11 R.F. SOAR; c.w. class-B operation;  $f = 175\text{ MHz}$ ;  $V_{CE} = 28\text{ V}$ ;  $R_{th\text{ mb-h}} = 0,45\text{ K/W}$   
The graph shows the permissible output power under nominal conditions (VSWR = 1) as a function of the expected VSWR during short-time mismatch conditions with heatsink temperatures as parameter.

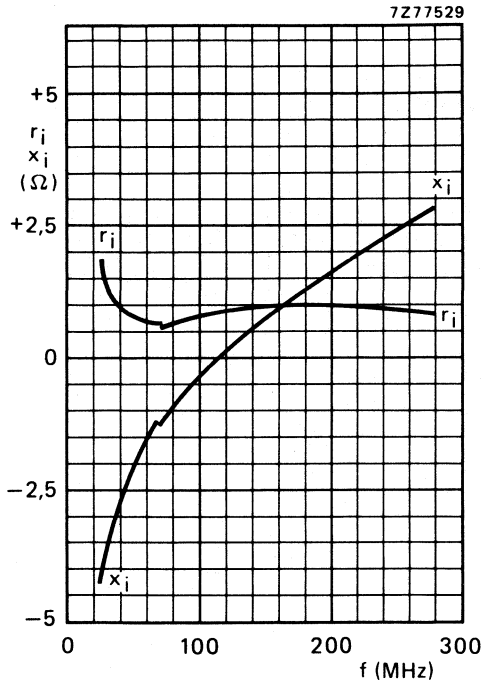


Fig. 12 Input impedance (series components).

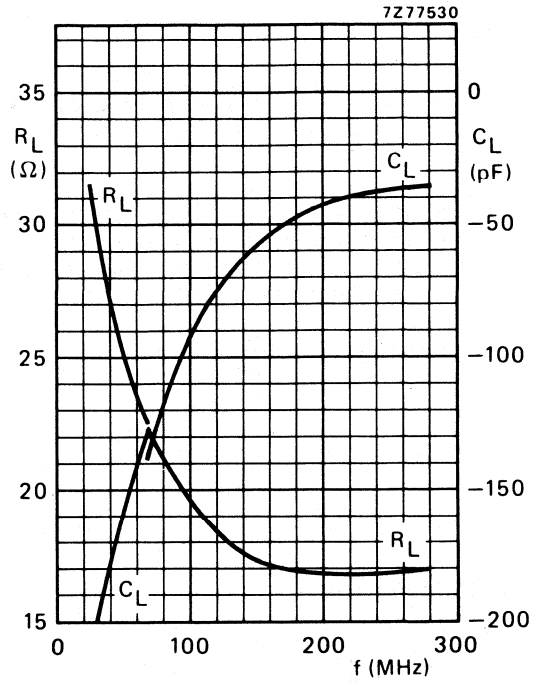


Fig. 13 Load impedance (parallel components).

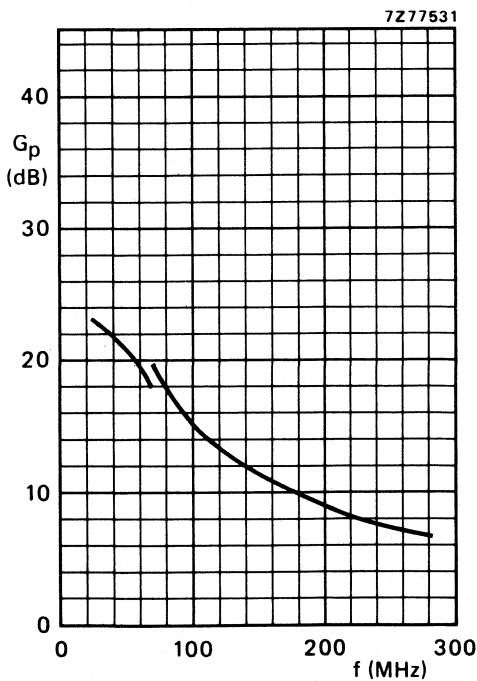


Fig. 14 Power gain versus frequency.

**OPERATING NOTE**

Below 70 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for r.f. only.

Conditions for Figs 12, 13 and 14:

Typical values;  $V_{CE} = 28$  V;  $P_L = 25$  W;  
 $T_h = 25$  °C.



## V.H.F. POWER TRANSISTOR

N-P-N planar epitaxial transistor intended for use in class-A, B and C operated mobile, industrial and military transmitters with a supply voltage of 28 V. The transistor is resistance stabilized. Every transistor is tested under severe load mismatch conditions. It has a plastic encapsulated stripline package. All leads are isolated from the stud.

### QUICK REFERENCE DATA

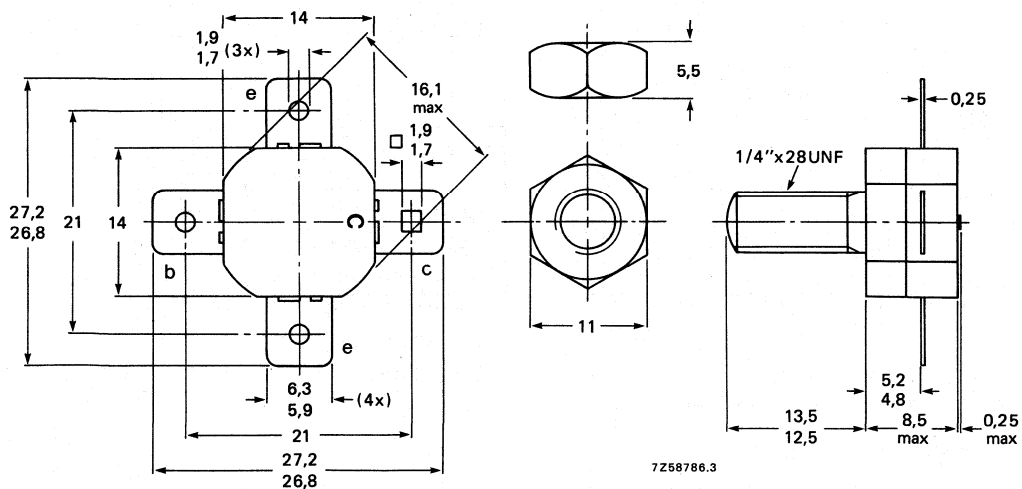
R.F. performance up to  $T_{mb} = 25\text{ }^{\circ}\text{C}$  in an unneutralized common-emitter class-B circuit

mode of operation	$V_{CE}$ V	f MHz	$P_S$ W	$P_L$ W	$I_C$ A	$G_p$ dB	$\eta$ %	$\bar{z}_i$ $\Omega$	$\bar{Y}_L$ mS
c.w.	28	175	< 10	50	< 2,75	> 7	> 65	$0,8 + j1,45$	$125 - j66$

### MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-55.



Torque on nut: min. 2,3 Nm  
(23 kg cm)  
max. 2,7 Nm  
(27 kg cm)

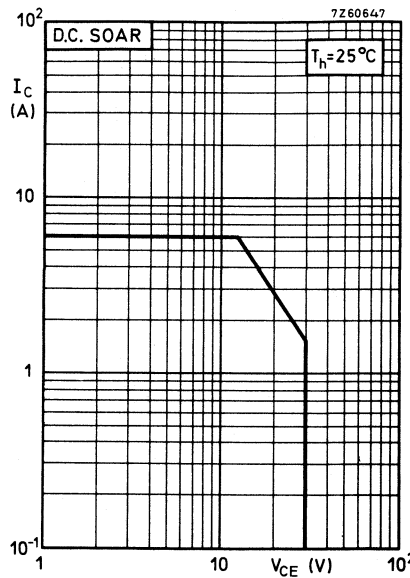
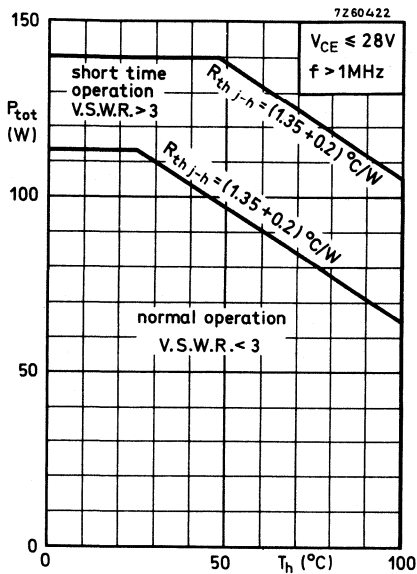
Diameter of clearance hole in heatsink: max. 6,4 mm.  
Mounting hole to have no burrs at either end.  
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

**PRODUCT SAFETY** This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) peak value	$V_{CBOM}$ max.	65 V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	36 V
Emitter-base voltage (open collector)	$V_{EBO}$ max.	4 V
Collector current (average)	$I_{C(AV)}$ max.	6 A
Collector current (peak value) $f > 1$ MHz	$I_{CM}$ max.	12 A
Total power dissipation up to $T_{mb} = 25^\circ\text{C}$ $f > 1$ MHz	$P_{tot}$ max.	130 W



Storage temperature  
Operating junction temperature

$T_{stg}$	-65 to +200 $^\circ\text{C}$
$T_j$	max. 200 $^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to mounting base  
From mounting base to heatsink

$R_{th\ j-mb}$	=	1.35 K/W
$R_{th\ mb-h}$	=	0.2 K/W

## CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

## Breakdown voltages

Collector-base voltage open emitter, $I_C = 100\text{ mA}$	$V_{(BR)CBO}$	>	65	V
Collector-emitter voltage open base, $I_C = 100\text{ mA}$	$V_{(BR)CEO}$	>	36	V
Emitter-base voltage open collector; $I_E = 25\text{ mA}$	$V_{(BR)EBO}$	>	4	V

## Transient energy

$L = 25\text{ mH}$ ;  $f = 50\text{ Hz}$

open base	E	>	8	ms
$-V_{BE} = 1.5\text{ V}$ ; $R_{BE} = 33\ \Omega$	E	>	8	ms

## D. C. current gain

$I_C = 1\text{ A}$ ;  $V_{CE} = 5\text{ V}$

$h_{FE}$	10 to 120
----------	-----------

## Transition frequency

$I_C = 6\text{ A}$ ;  $V_{CE} = 20\text{ V}$

$f_T$	typ. 500	MHz
-------	----------	-----

Collector capacitance at  $f = 1\text{ MHz}$ 

$I_E = I_e = 0$ ;  $V_{CB} = 30\text{ V}$

$C_c$	typ. 75	pF
	< 130	pF

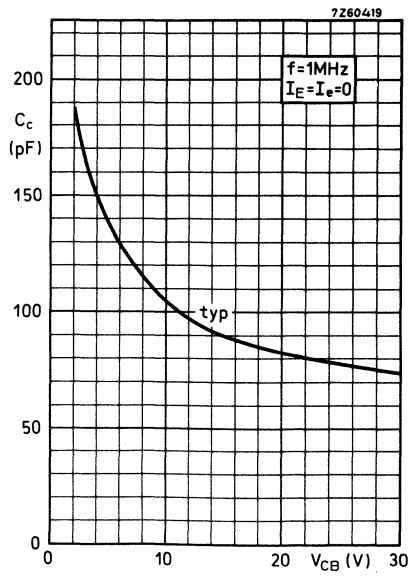
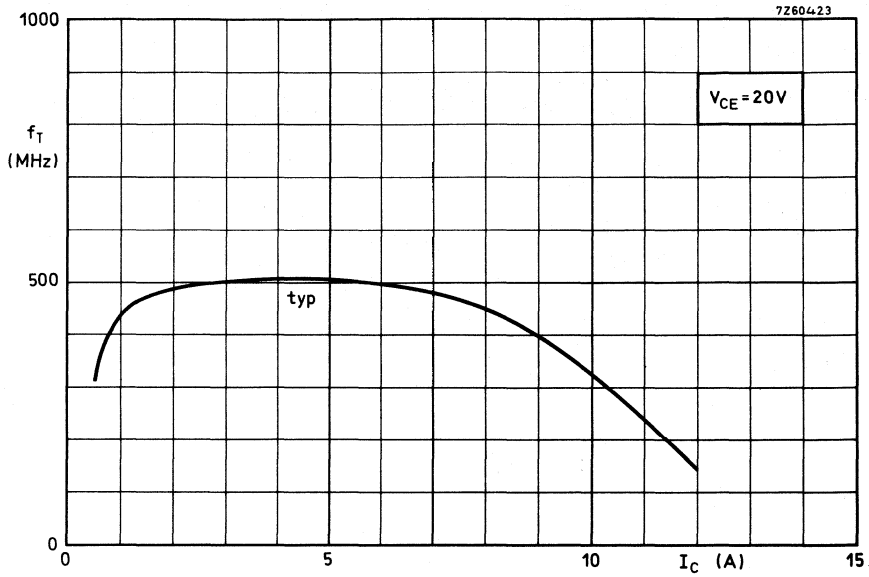
## Feedback capacitance

$I_C = 100\text{ mA}$ ;  $V_{CE} = 30\text{ V}$

$-C_{re}$	typ. 47	pF
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## Collector-stud capacitance

$C_{cs}$	typ. 3.5	pF
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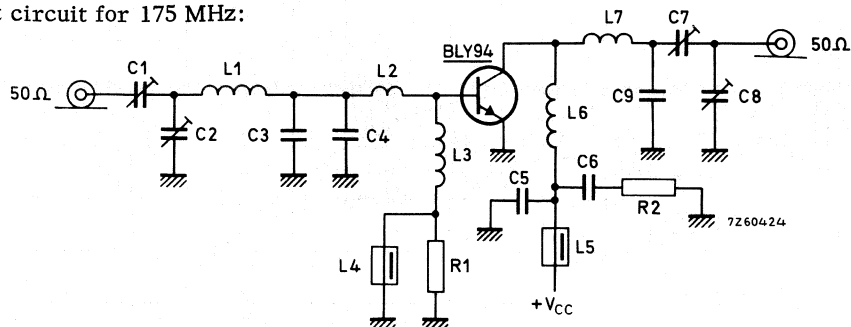
## APPLICATION INFORMATION

## R. F. performance in c. w. operation (unneutralised common-emitter class B circuit)

$f = 175 \text{ MHz}$ ;  $T_{mb}$  up to  $25^\circ\text{C}$

$V_{CC}$ (V)	$P_S$ (W)	$P_L$ (W)	$I_C$ (A)	$G_p$ (dB)	$\eta$ (%)	$\bar{z}_i$ ( $\Omega$ )	$\bar{Y}_L$ (mS)
28	< 10	50	< 2.75	> 7	> 65	$0.8+j1.45$	$125-j66$

Test circuit for 175 MHz:

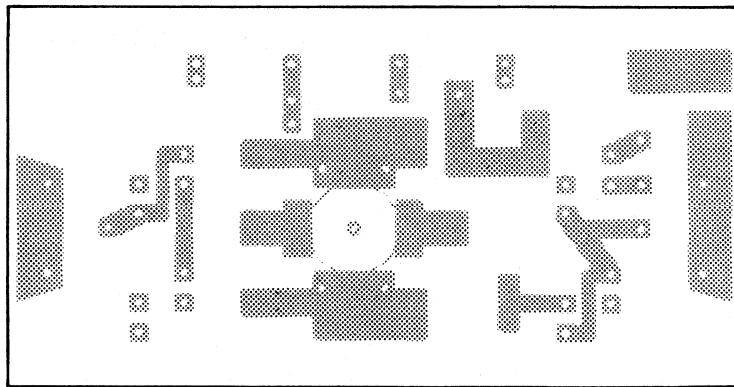
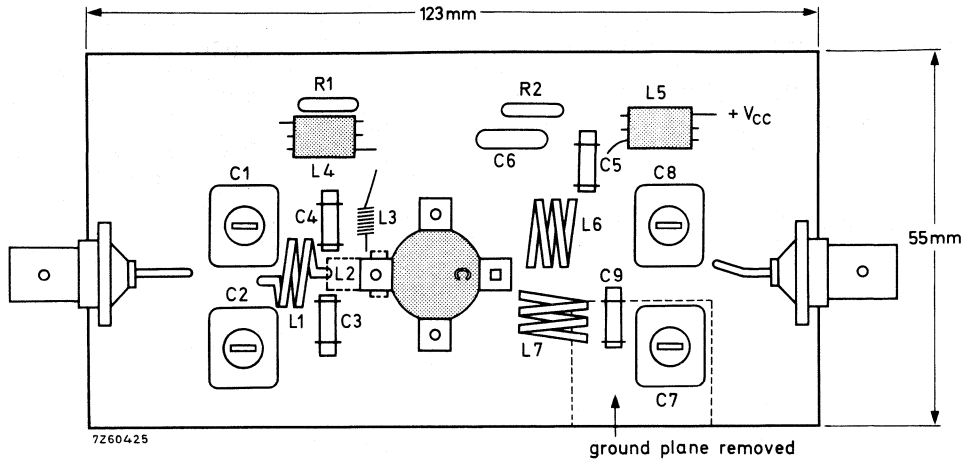


## List of components:

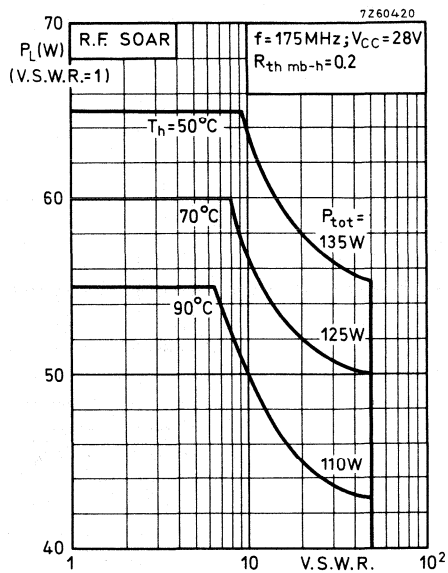
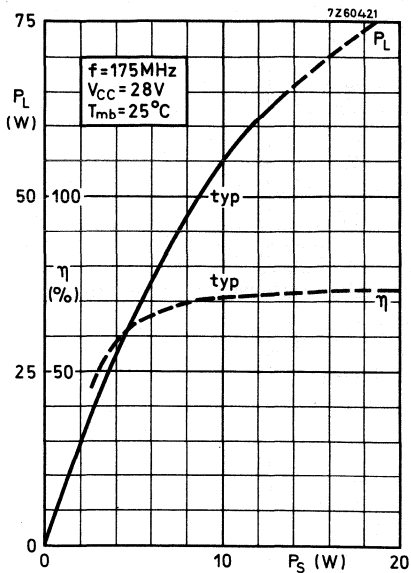
- C1 = 2 to 20 pF film dielectric trimmer (code number 2222 809 07004)  
 C2 = 4 to 40 pF film dielectric trimmer (code number 2222 809 07008)  
 C3 = C4 = 56 pF ceramic  
 C5 = 100 pF ceramic  
 C6 = 100 nF polyester  
 C7 = 4 to 60 pF film dielectric trimmer (code number 2222 809 07011)  
 C8 = 4 to 100 pF film dielectric trimmer (code number 2222 809 07015)  
 C9 = 6.8 pF ceramic  
 L1 = 36 nH; 2 turns enamelled Cu wire (1.5 mm); int. diam. 7 mm; length 5 mm; lead length 2 x 5 mm  
 L2 = formed by the metallization on the p. c. board; see component lay-out  
 L3 = 100 nH; 7 turns closely wound enamelled Cu wire (0.5 mm); int. diam 3 mm; lead length 2 x 5 mm  
 L4 = L5 = ferrocube choke (code number 4312 020 36640)  
 L6 = 53 nH; 2 turns enamelled Cu wire (1.5 mm); int. diam. 10 mm; length 5.2 mm; lead length 2 x 5 mm  
 L7 = 46 nH; 2 turns enamelled Cu wire (1.5 mm); int. diam. 9 mm; length 5.4 mm; lead length 2 x 5 mm  
 R1 = R2 = 10  $\Omega$  carbon

APPLICATION INFORMATION (continued)

Component lay-out and printed circuit board for 175 MHz test circuit.

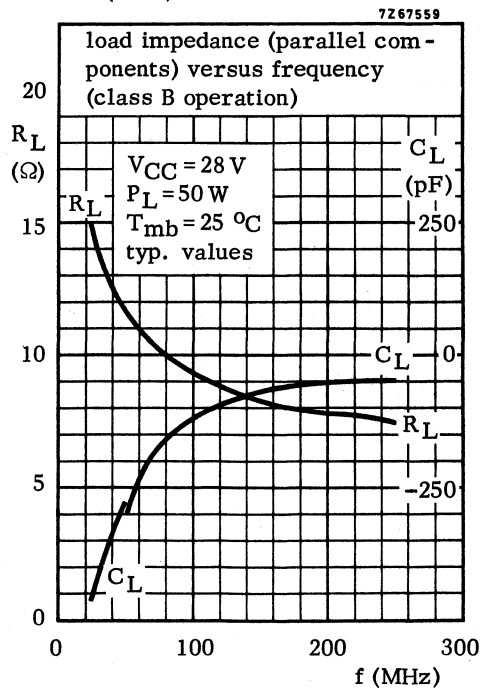
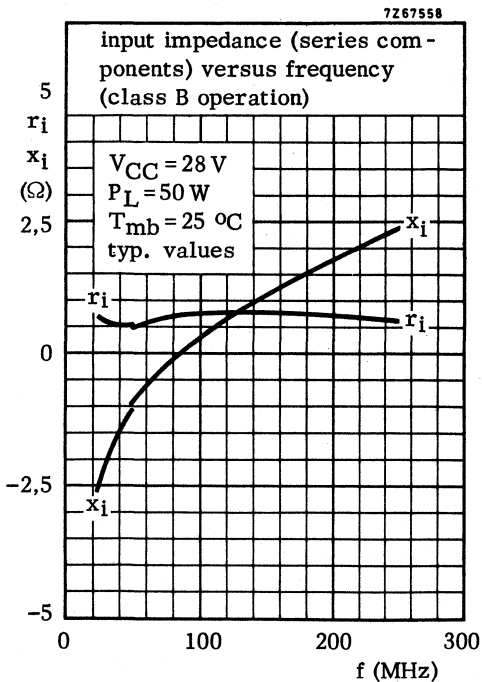
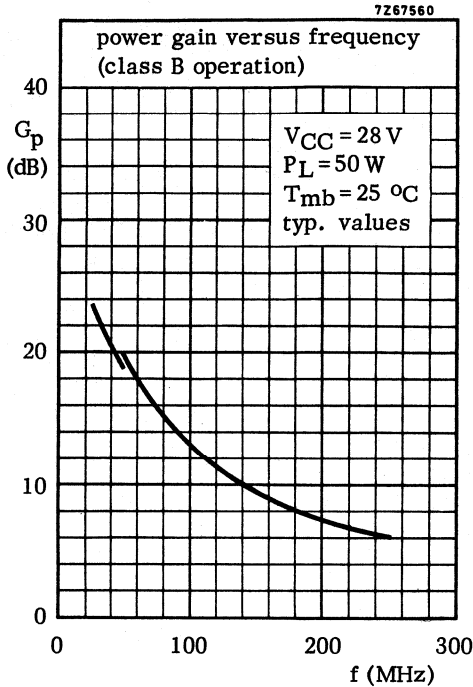


The circuit and the components are situated on one side of the epoxy fibre-glass board, the other side being fully metallised to serve as earth. Earth connections are made by means of hollow rivets.



For high voltage operation, a stabilized power supply is generally used. The graph shows the allowable output power under nominal conditions as a function of the V.S.W.R., with heat-sink temperature as parameter.

**OPERATING NOTE** Below 50 MHz a base-emitter resistor of 10  $\Omega$  is recommended to avoid oscillation. This resistor must be effective for both d. c. and r. f.





## SILICON EPITAXIAL PLANAR OVERLAY TRANSISTORS

The **2N3553** is an n-p-n overlay transistor in a TO-39 metal envelope with the collector connected to the case. The **2N3375** and the **2N3632** are n-p-n overlay transistors in TO-60 metal envelopes with the electrodes insulated from the studs.

The **2N3553** and the **2N3375** are intended for v.h.f./u.h.f. and the **2N3632** for v.h.f. transmitting applications.

### QUICK REFERENCE DATA

		2N3553	2N3375	2N3632	
Collector-emitter voltage -V <sub>BE</sub> = 1,5 V	V <sub>CEX</sub> max.	65	65	65	V
Collector-emitter voltage (open base)	V <sub>CEO</sub> max.	40	40	40	V
Collector current (peak value)	I <sub>CM</sub> max.	1,0	1,5	3,0	A
Total power dissipation up to T <sub>mb</sub> = 25 °C	P <sub>tot</sub> max.	7	11,6	23	W
Junction temperature	T <sub>j</sub> max.	200	200	200	°C
Transition frequency I <sub>C</sub> = 125 mA; V <sub>CE</sub> = 28 V	f <sub>T</sub> typ.	500	500	—	MHz
I <sub>C</sub> = 250 mA; V <sub>CE</sub> = 28 V	f <sub>T</sub> typ.	—	—	400	MHz

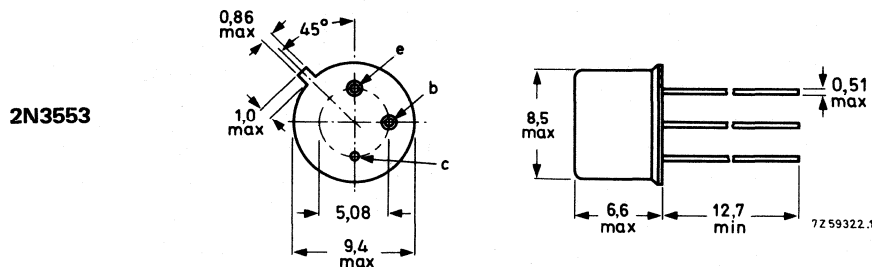
R.F. performance at V<sub>CE</sub> = 28 V

type number	f (MHz)	P <sub>o</sub> (W)	P <sub>i</sub> (W)	η (%)
2N3553	175	2,5	< 0,25	> 50
2N3375	100	7,5	< 1	> 65
2N3375	400	> 3	1	> 40
2N3632	175	> 13,5	3,5	> 70

### MECHANICAL DATA

Dimensions in mm

Fig. 1a TO-39; collector connected to case.



Maximum lead diameter is guaranteed only for 12,7 mm.

Accessories: 56245 (distance disc).

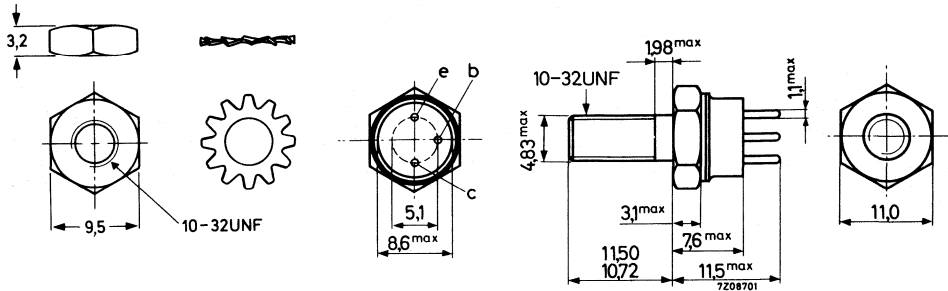
2N3375  
2N3553  
2N3632

**MECHANICAL DATA** (continued)

Dimensions in mm

Fig. 1b TO-60 (2N3375 and 2N3632).

The top pins should not be bent.



Torque on nut: min. 0,8 Nm ( 8 kg cm)  
max. 1,7 Nm (17 kg cm)

Diameter of clearance hole in heatsink: 4,8 mm to 5,2 mm.

**P.S. This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.**

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CB0}$	max.	65	V
Collector-emitter voltage	$V_{CEX}$	max.	65	V
$I_C \leq 200$ mA; $-V_{BE} = 1,5$ V	$V_{CEO}$	max.	40	V
(open base); $I_C \leq 200$ mA	$V_{EBO}$	max.	4	V
Emitter-base voltage (open collector)				
Collector current				
d.c.	$I_C$	max.	0,35	1 A
peak value	$I_{CM}$	max.	1,0	3 A
Total power dissipation	$P_{tot}$	max.	7	11,6
up to $T_{mb} = 25$ °C				23 W
Storage temperature	$T_{stg}$		-65 to +200 °C	
Junction temperature	$T_j$	max.	200 °C	

## THERMAL RESISTANCE

		2N3553	2N3375	2N3632
From junction to mounting base	$R_{th\ j-mb}$	= 25	15	7.5 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0.6	0.6 K/W

## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

## Collector cut-off current

		2N3553	2N3375	2N3632
$I_B = 0; V_{CE} = 30\text{ V}$	$I_{CEO}$	< 100	100	250 $\mu\text{A}$

## Breakdown voltages

$I_E = 0; I_C = 250\text{ }\mu\text{A}$	$V_{(BR)CBO}$	> 65	65	65 V
$I_C$ up to 200 mA $-V_{BE} = 1.5\text{ V}; R_B = 33\text{ }\Omega$ <sup>1)</sup>	$V_{(BR)CEX}$	> 65	65	65 V
$I_B = 0$ <sup>1)</sup>	$V_{(BR)CEO}$	> 40	40	40 V
$I_C = 0; I_E = 250\text{ }\mu\text{A}$	$V_{(BR)EBO}$	> 4	4	4 V

## Base-emitter voltage

$I_C = 250\text{ mA}; V_{CE} = 5\text{ V}$	$V_{BE}$	< 1.5		V
$I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$	$V_{BE}$	<	1.5	V
$I_C = 1000\text{ mA}; V_{CE} = 5\text{ V}$	$V_{BE}$	<		1.5 V

## Saturation voltage

$I_C = 250\text{ mA}; I_B = 50\text{ mA}$	$V_{CEsat}$	< 1.0		V
$I_C = 500\text{ mA}; I_B = 100\text{ mA}$	$V_{CEsat}$	<	1.0	V
$I_C = 1000\text{ mA}; I_B = 200\text{ mA}$	$V_{CEsat}$	<		1.0 V

<sup>1)</sup> Pulsed through an inductor of 25 mH;  $\delta = 0.5$ ;  $f = 50\text{ Hz}$

2N3375  
2N3553  
2N3632

CHARACTERISTICS (continued)

$T_j = 25^\circ\text{C}$  unless otherwise specified

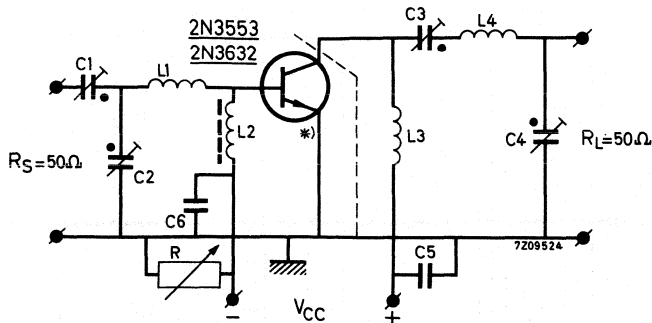
D.C. current gain		2N3553	2N3375	2N3632
$I_C = 125\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE} >$	15	15	
	$h_{FE} <$	200	200	
$I_C = 250\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE} >$	10	10	10
	$h_{FE} <$	100	100	150
$I_C = 1000\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE} >$			5
	$h_{FE} <$			110
Collector capacitance at $f = 1\text{ MHz}$				
$I_E = I_e = 0; V_{CB} = 28\text{ V}$	$C_c <$	10	10	20 pF
Collector-case capacitance				
	$<$		6	6 pF
Transition frequency				
$I_C = 125\text{ mA}; V_{CE} = 28\text{ V}$	$f_T$ typ.	500	500	MHz
$I_C = 250\text{ mA}; V_{CE} = 28\text{ V}$	$f_T$ typ.			400 MHz
Real part of input impedance at $f = 200\text{ MHz}$				
$I_C = 125\text{ mA}; V_{CE} = 28\text{ V}$	$\text{Re}(h_{ie}) <$	20	20	$\Omega$
$I_C = 250\text{ mA}; V_{CE} = 28\text{ V}$	$\text{Re}(h_{ie}) <$			20 $\Omega$

R.F. performance at  $V_{CE} = 28\text{ V}$

	f (MHz)	$P_o$ (W)	$P_i$ (W)	$I_C$ (mA)	$\eta$ %	Test circuit at page
2N3553	175	2.5	$< 0.25$	$< 180$	$> 50$	I
2N3375	100	7.5	$< 1$	$< 410$	$> 65$	II
2N3375	400	$> 3$	1	270	$> 40$	III
2N3632	175	$> 13.5$	3.5	690	$> 70$	I

NOTE

The transistors can withstand an output V.S.W.R. of 3:1 varied through all phases under conditions mentioned in the table above.

**CHARACTERISTICS** (continued)Test circuit I (with the 2N3553 or the 2N3632 at  $f = 175$  MHz)

- \*) The length of the external emitter wire of the 2N3553 is 1.6 mm.  
The emitter of the 2N3632 should be connected to the case as short as possible.

**Components**

C1 = C2 = C3 = C4 = 4 to 29 pF air trimmer

C5 = 10 nF polyester

C6 = 100 pF ceramic

L1 = 1 turn Cu wire (1.0 mm); int. diam. 10 mm; leads 2 x 10 mm

L2 = Ferroxcube choke coil.  $Z$  (at  $f = 175$  MHz) =  $550 \Omega \pm 20\%$   
(code number 4312 020 36640)

L3 = 15 turns closely wound enamelled Cu wire (0.7 mm); int. diam. 4 mm

L4 = 3 turns closely wound enamelled Cu wire (1.5 mm); int. diam. 12 mm; leads  
2 x 20 mm

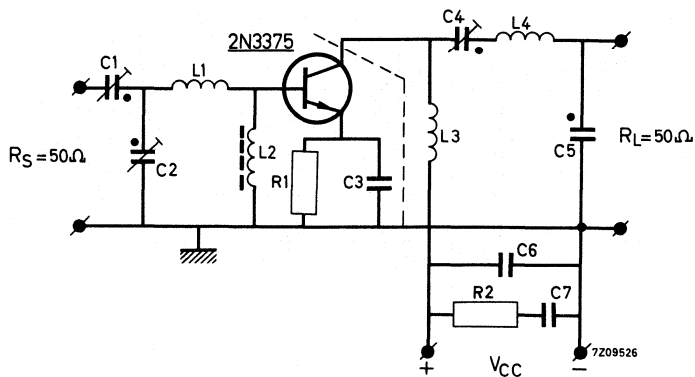
R = 0 for the 2N3553

R = 0 to  $2 \Omega$  for the 2N3632

2N3375  
2N3553  
2N3632

CHARACTERISTICS (continued)

Test circuit II (with the 2N3375 at  $f = 100$  MHz)



Components

C1 = C2 = 3.5 to 61.5 pF     air trimmer

C3 =                    10 nF     polyester

C4 = C5 =    4 to    29 pF     air trimmer

C6 =                    330 pF     ceramic

C7 =                    10 nF     polyester

L1 = 2 turns closely wound enamelled Cu wire (1.5 mm); int. diam. 10 mm; leads  
2 x 10 mm

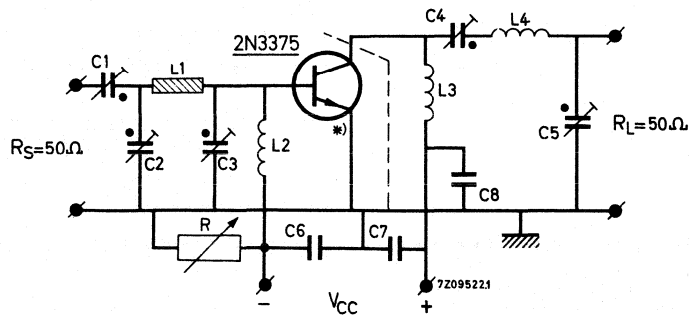
L2 = Ferroxcube choke coil.  $Z$  (at  $f = 100$  MHz) =  $700 \Omega \pm 20\%$   
(code number 4312 020 **36640**)

L3 = 23 turns closely wound enamelled Cu wire (0.7 mm); int. diam. 6 mm

L4 = 5 turns closely wound enamelled Cu wire (1.5 mm); int. diam. 12 mm; leads  
2 x 10 mm

R1 = 1.35  $\Omega$      carbon

R2 = 10  $\Omega$      carbon

**CHARACTERISTICS** (continued)Test circuit III (with the 2N3375 at  $f = 400$  MHz)

\*) The emitter should be connected to the case as short as possible.

**Components**

C1 = C2 = 0.7 to 6.7 pF      ceramic trimmer

C3 =      0.5 to 3.5 pF      ceramic trimmer

C4 = C5 =    3 to 19 pF      air trimmer

C6 = C7 =      15 pF      ceramic

C8 =      4700 pF      ceramic

L1 = 20 mm straight Cu wire; diam. 1.5 mm; spaced 8 mm from chassis

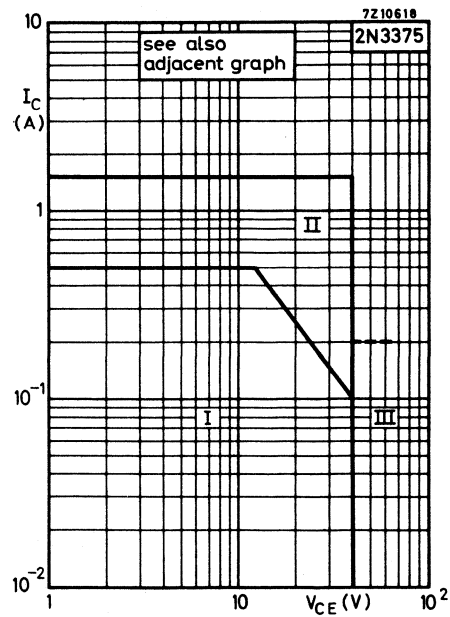
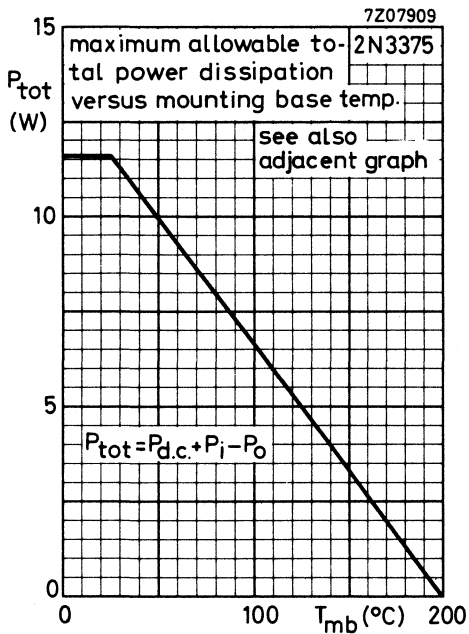
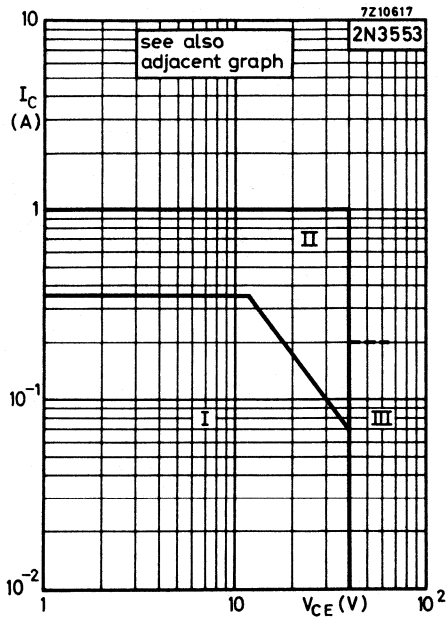
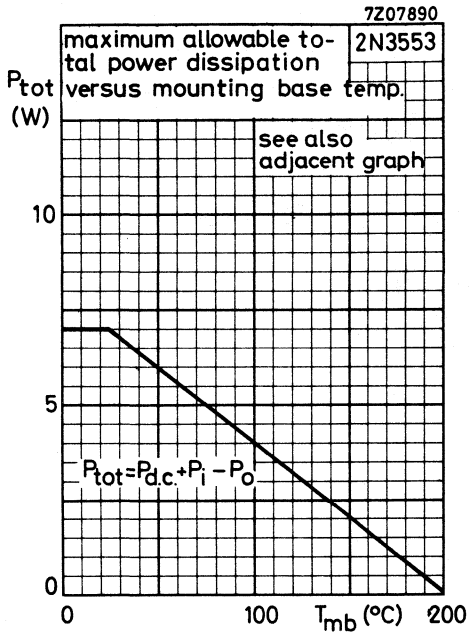
L2 = 17 turns closely wound enamelled Cu wire (0.5 mm); int. diam. 3 mm

L3 = 7 turns closely wound enamelled Cu wire (0.5 mm); int. diam. 3 mm

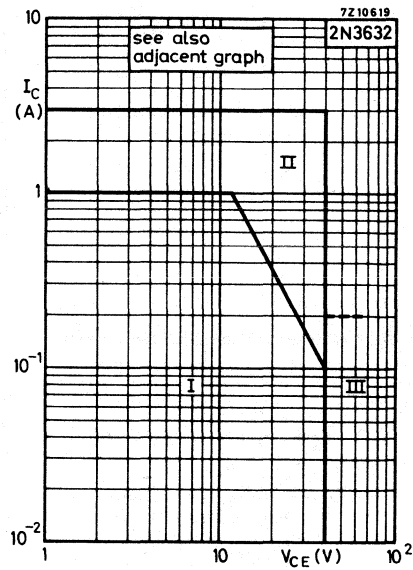
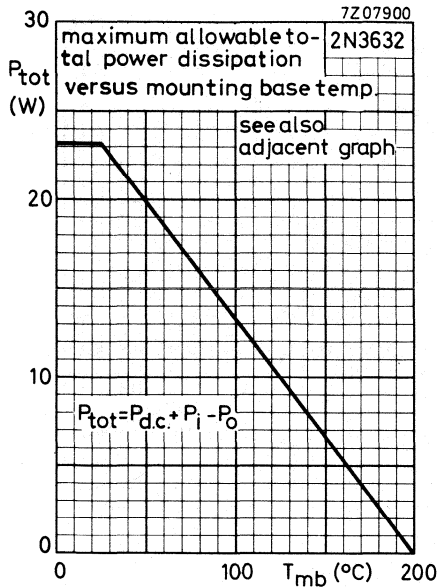
L4 = 1 turn Cu wire (1.5 mm); int. diam. 10 mm; leads 2 x 5 mm

R = 0 to 5  $\Omega$

2N3375  
 2N3553  
 2N3632

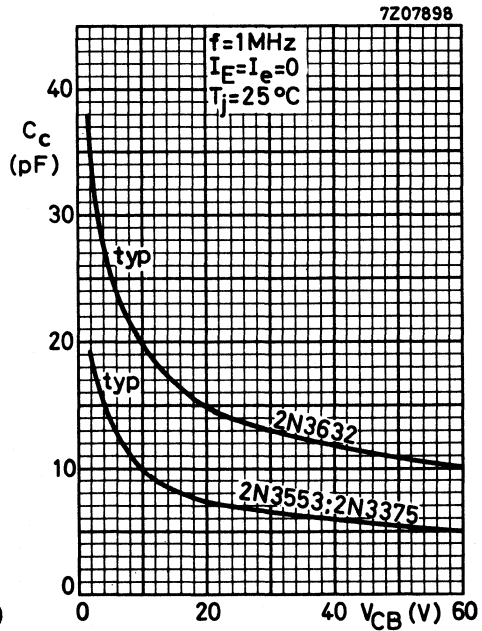
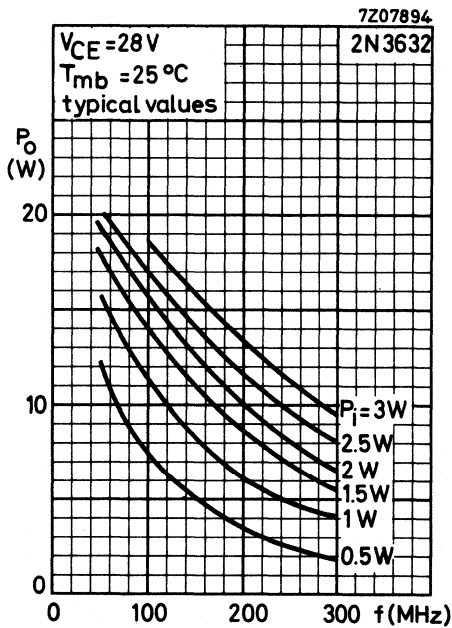
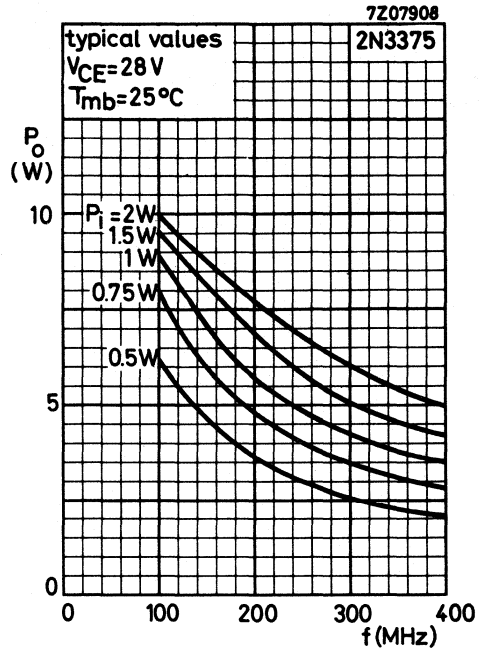
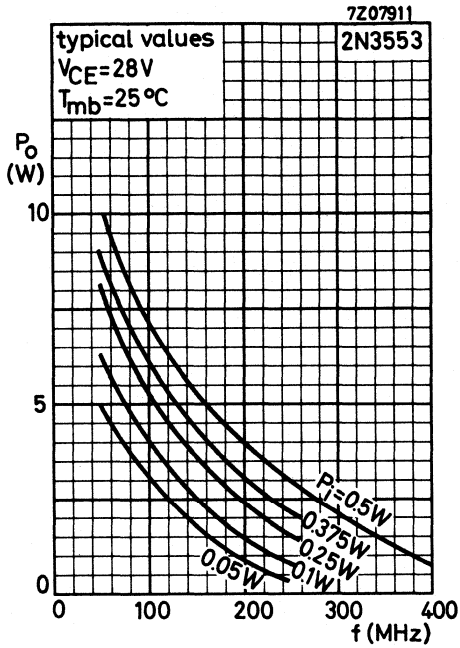


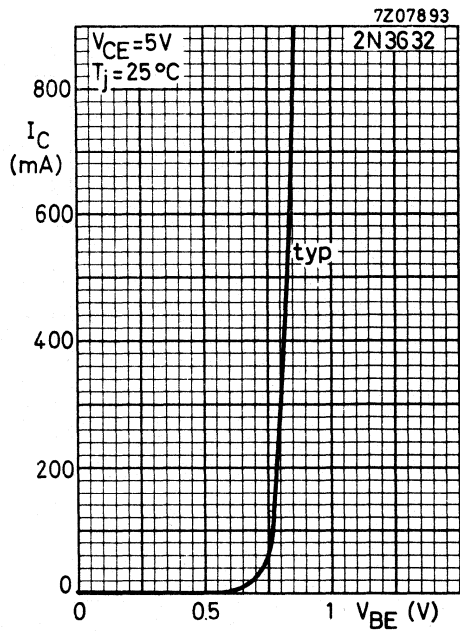
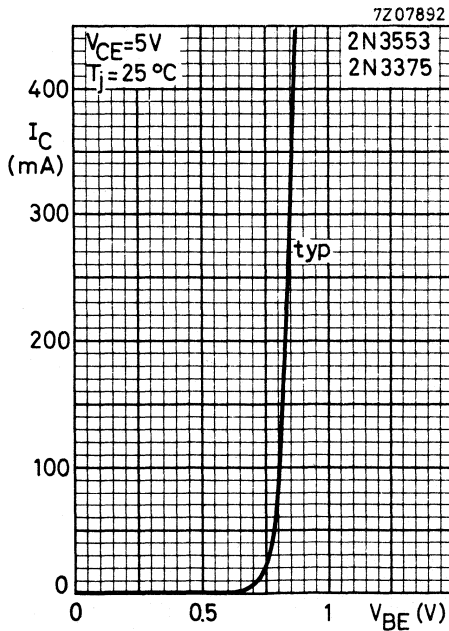
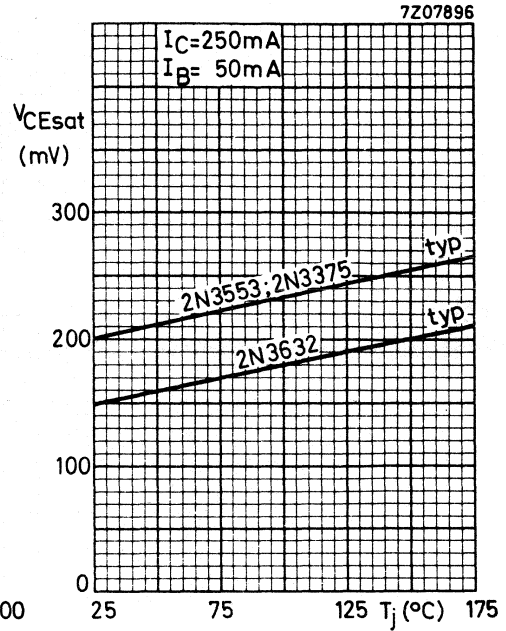
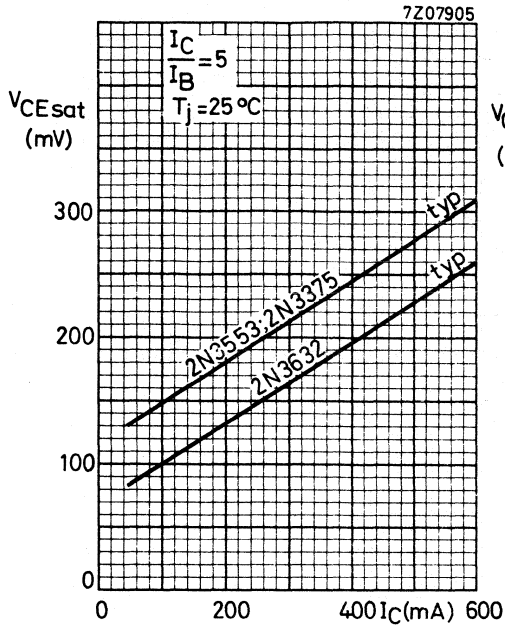




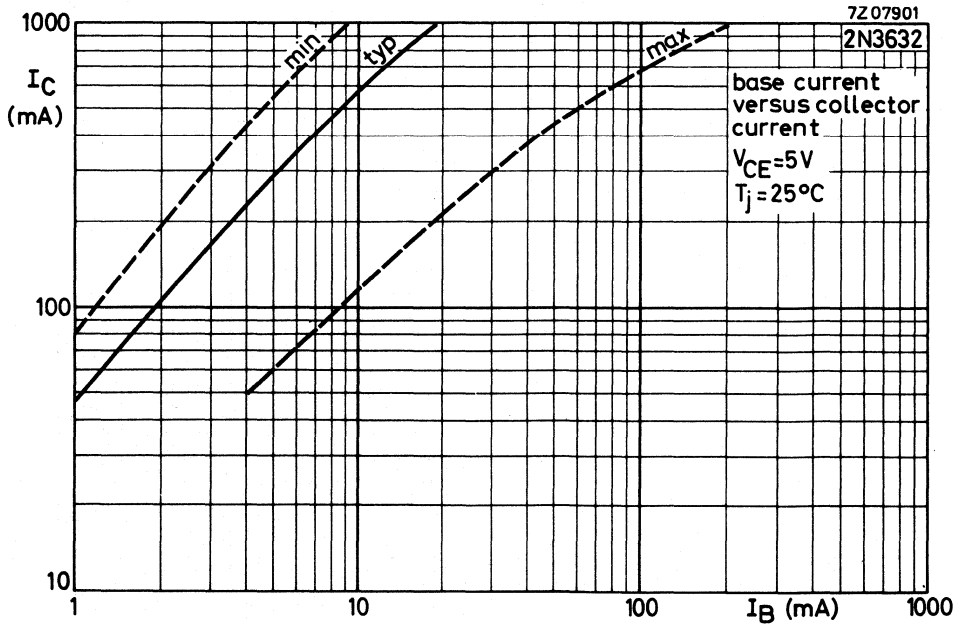
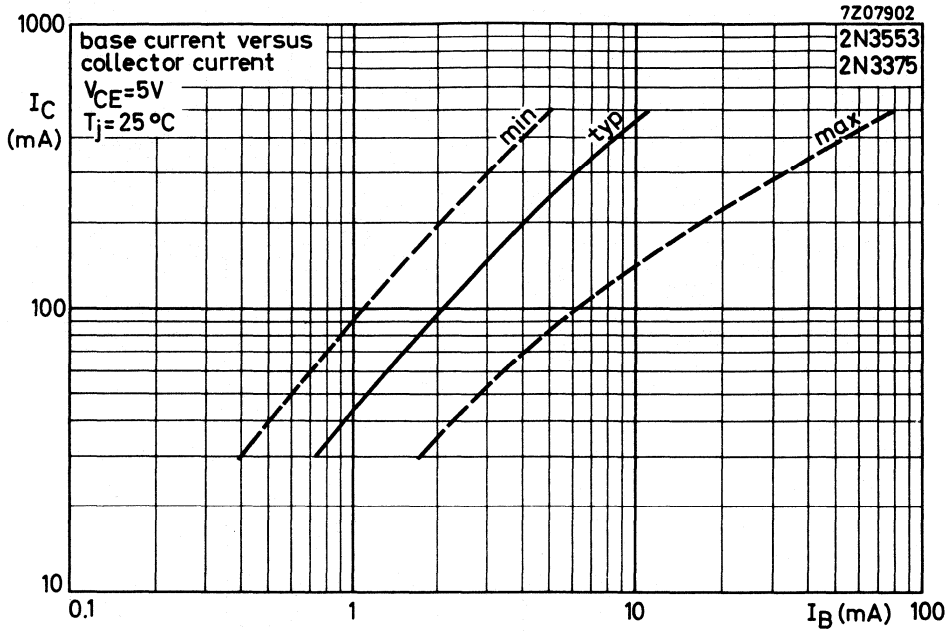
- I Region of permissible operation under all base-emitter conditions and at all frequencies, including d.c.
- II Additional region of operation at  $f \geq 1$  MHz.  
Care must be taken to reduce the d.c. adjustment to region I before removing the a.c. signal. This may be achieved by an appropriate bias in class A, B or C.
- III Operating during switching off in this region is allowed, provided the transistor is cut-off with  $-V_{BB} \leq 1.5$  V and  $R_{BE} \geq 33 \Omega$ ,  $I_C \leq 200$  mA and the transient energy does not exceed 0.5 mWs.

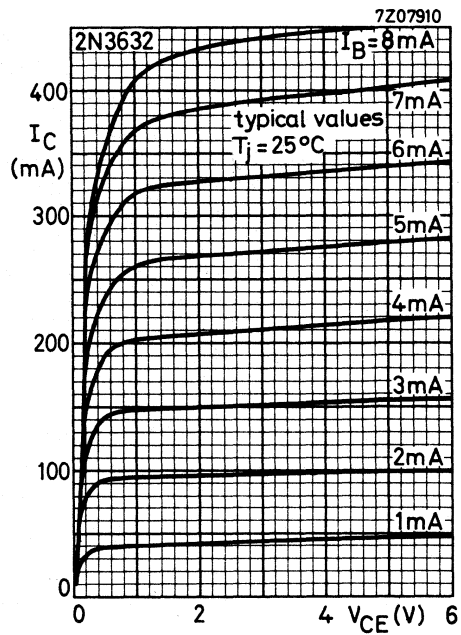
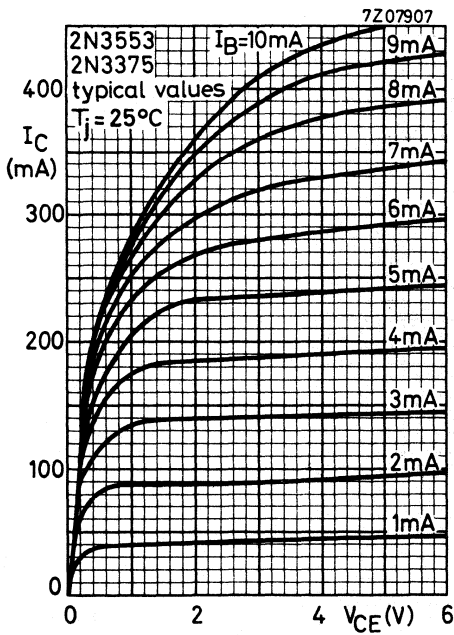
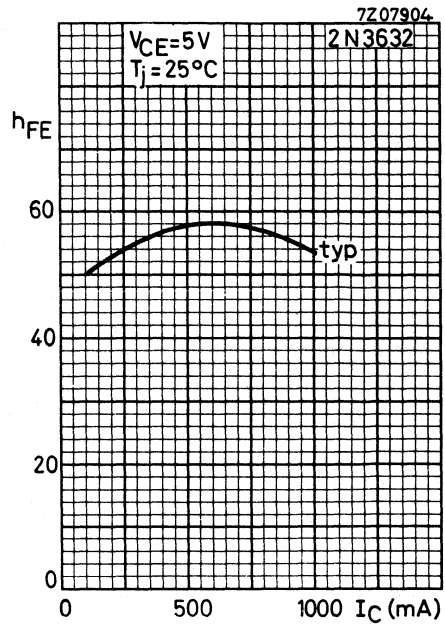
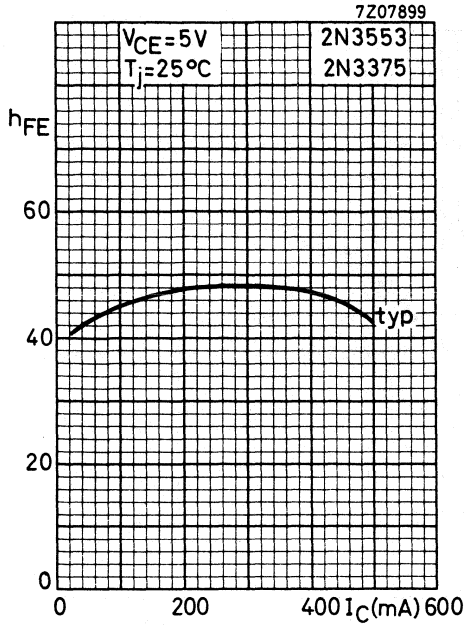
2N3375  
 2N3553  
 2N3632



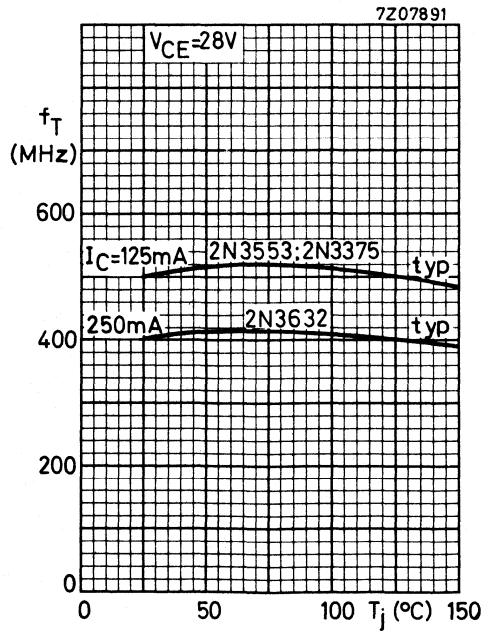
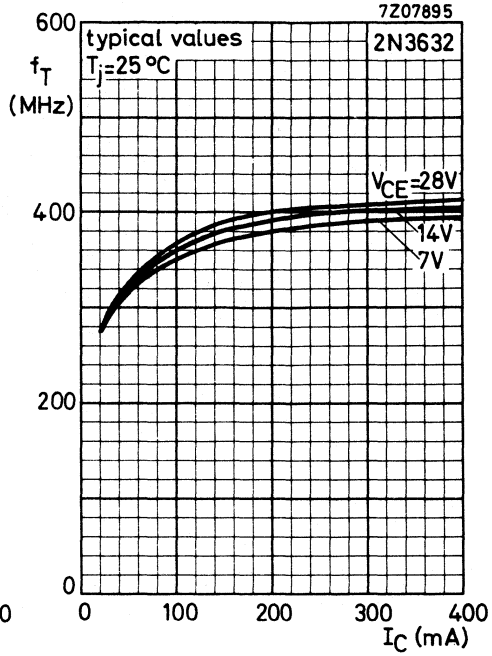
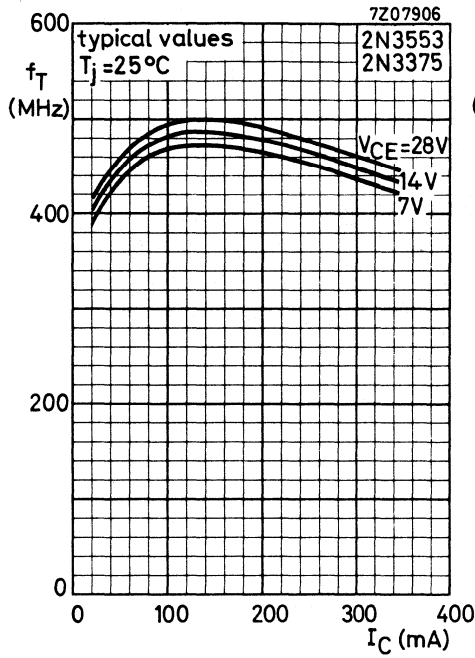


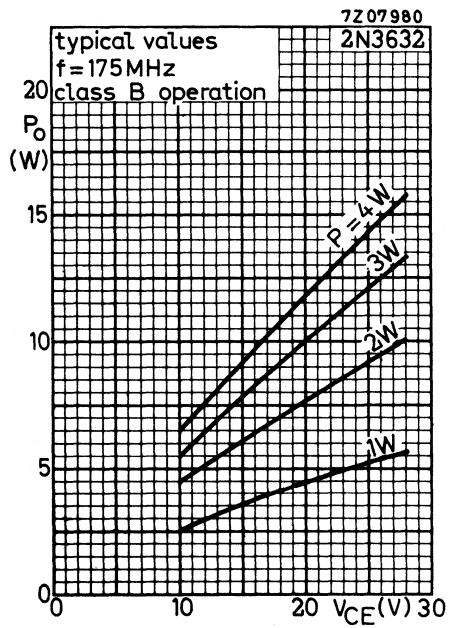
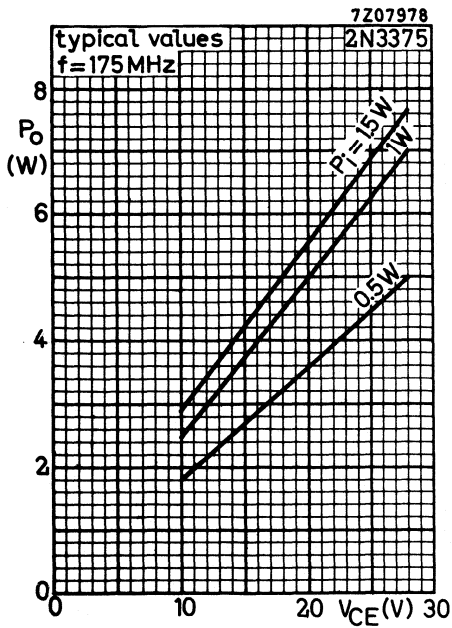
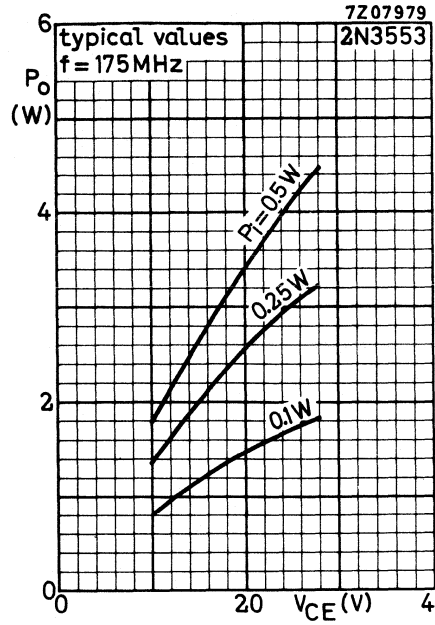
2N3375  
2N3553  
2N3632





2N3375  
 2N3553  
 2N3632









## SILICON PLANAR EPITAXIAL OVERLAY TRANSISTORS

N-P-N overlay transistors in TO-39 metal envelopes with the collector connected to the case. The devices are primarily intended for class-A, B or C amplifiers, frequency multiplier and oscillator circuits. The transistors are suitable in output, driver or pre-driver stages in v.h.f. and u.h.f. equipment.

### QUICK REFERENCE DATA

		2N3866	2N4427
Collector-emitter voltage $R_{BE} = 10 \Omega$	$V_{CER}$ max.	55	40 V
Collector-emitter voltage (open base)	$V_{CEO}$ max.	30	20 V
Emitter-base voltage (open collector)	$V_{EBO}$ max.	3,5	2,0 V
Collector current (d.c. or averaged over any 20 ms period)	$I_C$ max.	0,4	0,4 A
Total power dissipation up to $T_{mb} = 25^\circ C$	$P_{tot}$ max.	5	3,5 W
Junction temperature	$T_j$ max.	200	200 $^\circ C$
Transition frequency $I_C = 50 \text{ mA}; V_{CE} = 15 \text{ V}; f = 200 \text{ MHz}$	$f_T$ min.	500	500 MHz

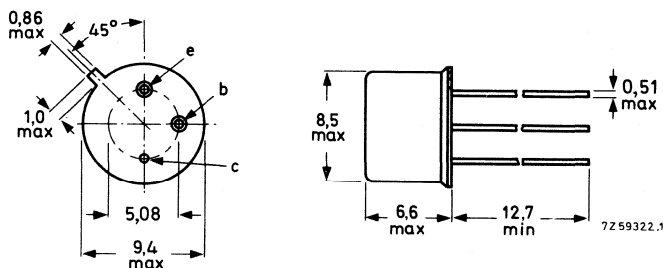
### R.F. performance

type number	f (MHz)	$V_{CE}$ (V)	$P_O$ (W)	$G_p$ (dB)	$\eta$ (%)
2N3866	400	28	1	> 10	> 45
2N4427	175	12	1	> 10	> 50

### MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-39; collector connected to case.



Maximum lead diameter is guaranteed only for 12,7 mm.

Accessories: 56245 (distance disc).

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

		2N3866	2N4427
Collector-base voltage (open emitter) <sup>1)</sup>	$V_{CBO}$ max.	55	40 V
Collector-emitter voltage <sup>1)</sup> $R_{BE} = 10 \Omega$	$V_{CER}$ max.	55	40 V
Collector-emitter voltage (open base) <sup>1)</sup>	$V_{CEO}$ max.	30	20 V
Emitter-base voltage (open collector) <sup>1)</sup>	$V_{EBO}$ max.	3.5	2.0 V
Collector current (d.c. or averaged over any 20 ms period) <sup>1)</sup>	$I_C$ max.	0.4	0.4 A
Collector current (peak value) <sup>1)</sup>	$I_{CM}$ max.	0.4	0.4 A
Total power dissipation up to $T_{mb} = 25 \text{ }^\circ\text{C}$ <sup>1)</sup>	$P_{tot}$ max.	5	3.5 W

Temperatures

Storage temperature	$T_{stg}$	-65 to +200	$^\circ\text{C}$
Junction temperature	$T_j$	max. 200	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air	$R_{th j-a}$	=	200	K/W
From junction to mounting base	$R_{th j-mb}$	=	35	K/W
From mounting base to heatsink mounted with top clamping washer of 56218	$R_{th mb-h}$	=	1.0	K/W
top clamping washer of 56218 and a boron nitride washer for electrical insulation	$R_{th mb-h}$	=	2.5	K/W

1) See also graphs indicating areas of permissible operation.

## CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

		2N3866	2N4427
Collector cut-off current			
$I_B = 0; V_{CE} = 28\text{ V}$	$I_{CEO}$	< 20	$\mu\text{A}$
$I_B = 0; V_{CE} = 12\text{ V}$	$I_{CEO}$	<	20 $\mu\text{A}$
Breakdown voltages			
$I_E = 0; I_C = 100\text{ }\mu\text{A}$	$V_{(BR)CBO}$	> 55	40 V
$I_C = 5\text{ mA}; R_{BE} = 10\text{ }\Omega$	$V_{(BR)CER}$	> 55	40 V
$I_B = 0; I_C = 5\text{ mA}$	$V_{(BR)CEO}$	> 30	20 V
$I_C = 0; I_E = 100\text{ }\mu\text{A}$	$V_{(BR)EBO}$	> 3,5	2 V
Collector-emitter saturation voltage			
$I_C = 100\text{ mA}; I_B = 20\text{ mA}$	$V_{CEsat}$	< 1,0	0,5 V
D.C. current gain			
$I_C = 50\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	10 to 200	10 to 200
$I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	> 5	
$I_C = 360\text{ mA}; V_{CE} = 5\text{ V}$	$h_{FE}$	>	
Transition frequency			
$I_C = 50\text{ mA}; V_{CE} = 15\text{ V}; f = 200\text{ MHz}$	$f_T$	$\geq 500$	500 MHz
Collector capacitance			
$V_{CB} = 28\text{ V}; I_E = I_e = 0; f = 1\text{ MHz}$	$C_c$	< 3	pF
$V_{CB} = 12\text{ V}; I_E = I_e = 0; f = 1\text{ MHz}$	$C_c$	<	4 pF

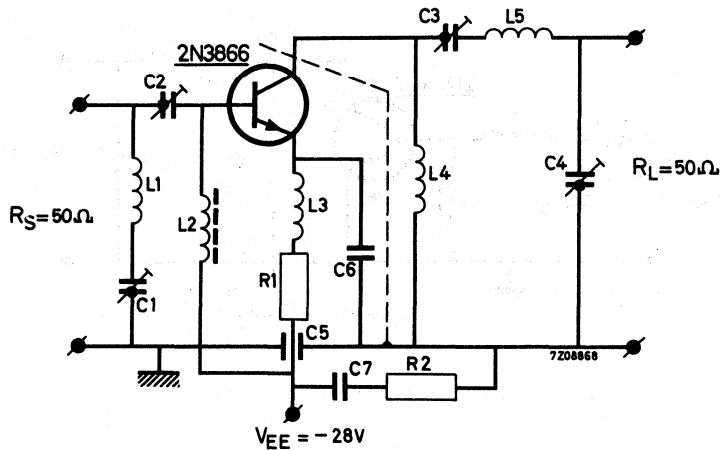
R.F. performance at  $T_{mb} = 25\text{ }^\circ\text{C}$ 

	f (MHz)	$V_{CE}$ (V)	$P_o$ (W)	Gp (dB)	$I_C$ (mA)	$\eta$ (%)	test circuit
2N3866	100	28	1,8	> 10	< 107	> 60	
2N3866	250	28	1,5	> 10	< 107	> 50	
2N3866	400	28	1,0	> 10	< 79	> 45	
2N4427	175	12	1,0	> 10	< 167	> 50	
2N4427	470	12	0,4	> 10	67	50	

\* The transistor can withstand an output V.S.W.R. of 3 : 1 varied through all phases for conditions, mentioned in the table above.

CHARACTERISTICS (continued)

Test circuit I (with the 2N3866 at  $f = 400$  MHz)



- |                |              |              |
|----------------|--------------|--------------|
| C1 = C2 = C3 = | 4 to 29 pF   | air trimmer  |
| C4 =           | 4 to 14 pF   | air trimmer  |
| C5 =           | 1 nF         | feed through |
| C6 =           | 12 pF        |              |
| C7 =           | 12 nF        |              |
| R1 =           | 5.6 $\Omega$ |              |
| R2 =           | 10 $\Omega$  |              |

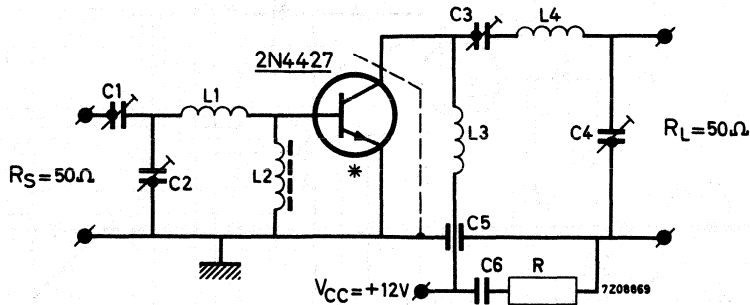
L1 = 2 turns Cu wire (1 mm); int. diam. 6 mm; winding pitch 3 mm

L2 = Ferroxcube choke coil; Z (at  $f = 250$  MHz) = 450  $\Omega$  (code number 4312 020 36690)

L3 = L4 = 6 turns enamelled Cu wire (0.5 mm); int. diam. 3.5 mm (100 nH)

L5 = 2 turns Cu wire (1 mm); int. diam. 7 mm; winding pitch 2.5 mm;  
leads 2x15 mm.

## APPLICATION INFORMATION (continued)

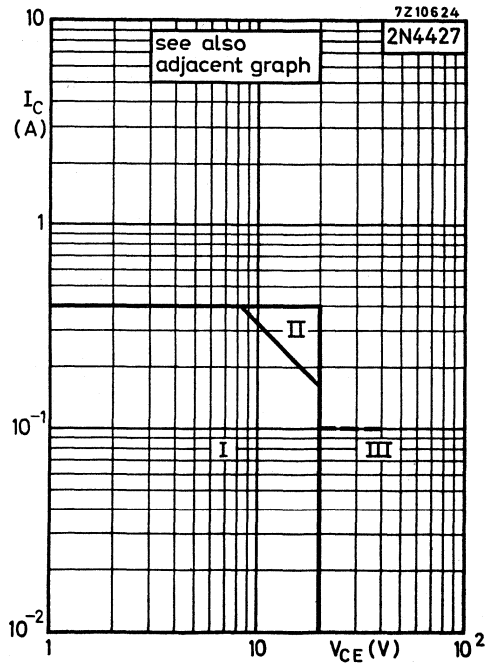
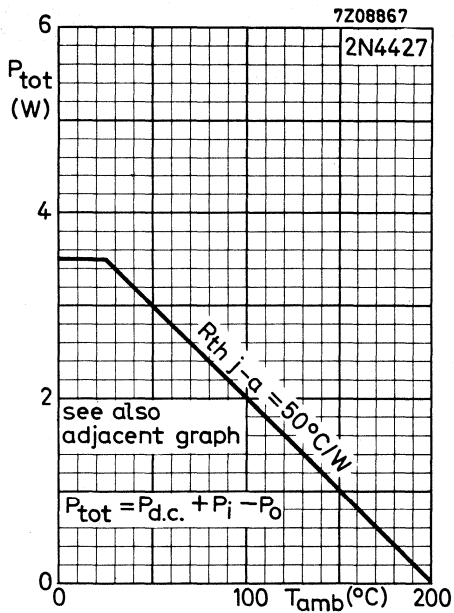
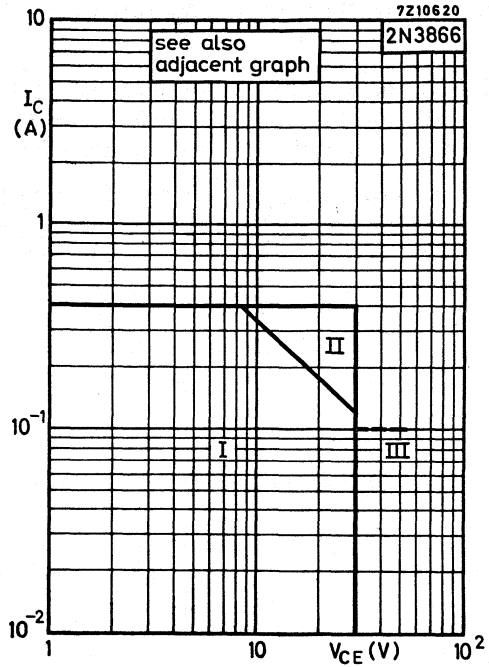
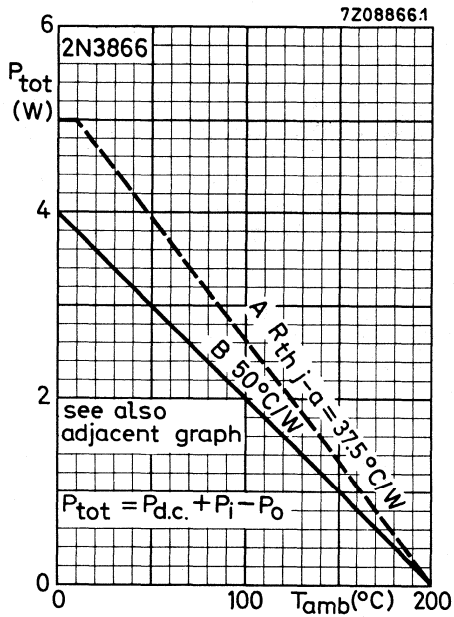
Test circuit II (with the 2N4427 at  $f = 175$  MHz)

\*) The length of the external emitter wire is 1.6 mm

C1 = C2 = C3 = C4 =	4 to 29 pF	air trimmer
C5 =	1 nF	feed through
C6 =	12 nF	
R =	10 $\Omega$	

- L1 = 2 turns Cu wire (1 mm); int. diam. 6 mm; winding pitch 2 mm; leads 2x10 mm  
 L2 = Ferroxcube choke coil; Z (at  $f = 175$  MHz) = 550  $\Omega$  (code number 4312 020 36640)  
 L3 = 2 turns Cu wire (1 mm); int. diam. 5 mm; winding pitch 2 mm; leads 2x10 mm  
 L4 = 3 turns Cu wire (1.5 mm); int. diam. 10 mm; winding pitch 2 mm; leads 2x15 mm

2N3866  
2N4427



- I Region of permissible operation under all base-emitter conditions and at all frequencies, including d.c.
- II Additional region of operation at  $f \geq 1$  MHz.  
Care must be taken to reduce the d.c. adjustment to region I before removing the a.c. signal. This may be achieved by an appropriate bias in class A, B or C.
- III Operating during switching off in this region is allowed, provided the transistor is cut-off with  $-V_{BB} \leq 1.5$  V and  $R_{BE} \geq 33 \Omega$ ,  $I_C \leq 100$  mA and the transient energy does not exceed 0.125 mWs.





## SILICON PLANAR EPITAXIAL OVERLAY TRANSISTORS

The 2N3924 is an n-p-n overlay transistor in a TO-39 metal envelope with the collector connected to the case. The 2N3926 and the 2N3927 are n-p-n overlay transistors in TO-60 metal envelopes with the emitter connected to the case.

The transistors are intended for v.h.f. transmitting applications.

### QUICK REFERENCE DATA

		2N3924	2N3926	2N3927	
Collector-emitter voltage -V <sub>BE</sub> = 1,5 V	V <sub>CEX</sub> max.	36	36	36	V
Collector-emitter voltage (open base)	V <sub>CEO</sub> max.	18	18	18	V
Collector current (peak value)	I <sub>CM</sub> max.	1,5	3,0	4,5	A
Total power dissipation up to T <sub>mb</sub> = 25 °C	P <sub>tot</sub> max.	7	11,6	23	W
Junction temperature	T <sub>j</sub> max.	200	200	200	°C
Transition frequency	f <sub>T</sub> >	250	250	—	MHz
I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 13,5 V	f <sub>T</sub> >	—	—	200	MHz
I <sub>C</sub> = 200 mA; V <sub>CE</sub> = 13,5 V					

R.F. performance at V<sub>CE</sub> = 13,5 V; f = 175 MHz

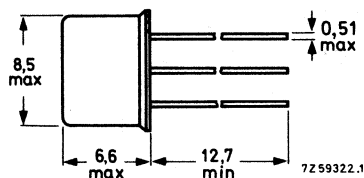
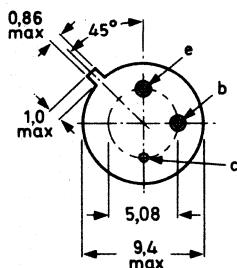
type number	P <sub>O</sub> (W)	P <sub>i</sub> (W)	η (%)
2N3924	4	< 1	> 70
2N3926	7	< 2	> 70
2N3927	12	< 4	> 80

### MECHANICAL DATA

Dimensions in mm

Fig. 1a TO-39; collector connected to case.

2N3924



Maximum lead diameter is guaranteed only for 12,7 mm.

Accessories: 56245 (distance disc).

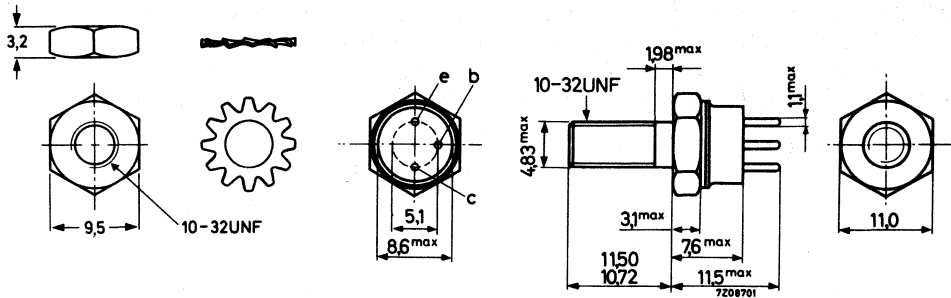
**MECHANICAL DATA (continued)**

Dimensions in mm

Fig. 1b TO-60 (2N3926 and 2N3927).

Emitter connected to case.

The top pins should not be bent.



Torque on nut: min. 0,8 Nm ( 8 kg cm)  
max. 1,7 Nm (17 kg cm)

Diameter of clearance hole in heatsink: 4,8 mm to 5,2 mm.

**P.S. This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.**

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$V_{CBO}$	max.	36	V	
Collector-emitter voltage $I_C \leq 400 \text{ mA}; -V_{BE} = 1,5 \text{ V}$ (open base); $I_C \leq 400 \text{ mA}$	$V_{CEX}$	max.	36	V	
	$V_{CEO}$	max.	18	V	
Emitter-base voltage (open collector)	$V_{EBO}$	max.	4	V	
Collector current	$I_C$	max.	0,5	1,0	1,5 A
		peak value	$I_{CM}$	max.	1,5
Total power dissipation up to $T_{mb} = 25 \text{ }^\circ\text{C}$	$P_{tot}$	max.	7	11,6	23 W
Storage temperature	$T_{stg}$		-65 to +200		$^\circ\text{C}$
Junction temperature	$T_j$	max.	200		$^\circ\text{C}$

**THERMAL RESISTANCE**

		2N3924	2N3926	2N3927
From junction to mounting base	$R_{th\ j-mb}$	= 25	15	7.5 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0.6	0.6 K/W

**CHARACTERISTICS** $T_j = 25\ ^\circ\text{C}$  unless otherwise specified

		2N3924	2N3926	2N3927
Collector cut-off current				
$I_E = 0; V_{CB} = 15\ \text{V}$	$I_{CBO}$	< 100	100	250 $\mu\text{A}$
$I_E = 0; V_{CB} = 15\ \text{V}; T_j = 150\ ^\circ\text{C}$	$I_{CBO}$	< 5	5	10 mA
Breakdown voltages				
$I_E = 0; I_C = 250\ \mu\text{A}$	$V_{(BR)CBO}$	> 36	36	36 V
$I_C$ up to 400 mA	$V_{(BR)CEX}$	> 36	36	36 V
$-V_{BE} = 1.5\ \text{V}; R_B = 33\ \Omega$ <sup>1)</sup>	$V_{(BR)CEO}$	> 18	18	18 V
$I_B = 0$ <sup>1)</sup>	$V_{(BR)CEO}$	> 18	18	18 V
$I_C = 0; I_E = 250\ \mu\text{A}$	$V_{(BR)EBO}$	> 4	4	4 V
Base-emitter voltage				
$I_C = 250\ \text{mA}; V_{CE} = 5\ \text{V}$	$V_{BE}$	< 1.5		V
$I_C = 500\ \text{mA}; V_{CE} = 5\ \text{V}$	$V_{BE}$	<	1.5	V
$I_C = 1000\ \text{mA}; V_{CE} = 5\ \text{V}$	$V_{BE}$	<		1.5 V
Saturation voltage				
$I_C = 250\ \text{mA}; I_B = 50\ \text{mA}$	$V_{CEsat}$	< 0.75		V
$I_C = 500\ \text{mA}; I_B = 100\ \text{mA}$	$V_{CEsat}$	<	0.75	V
$I_C = 1000\ \text{mA}; I_B = 200\ \text{mA}$	$V_{CEsat}$	<		1.0 V

<sup>1)</sup> Pulsed through an inductor of 25 mH;  $\delta = 0.5$ ;  $f = 50\ \text{Hz}$

**CHARACTERISTICS (continued)**

$T_j = 25^\circ\text{C}$  unless otherwise specified

**D.C. current gain**

		2N3924	2N3926	2N3927
$I_C = 250 \text{ mA}; V_{CE} = 5 \text{ V}$	$h_{FE} >$	10		
	$h_{FE} <$	150		
$I_C = 500 \text{ mA}; V_{CE} = 5 \text{ V}$	$h_{FE} >$		5	
	$h_{FE} <$		150	
$I_C = 1000 \text{ mA}; V_{CE} = 5 \text{ V}$	$h_{FE} >$			5
	$h_{FE} <$			150

**Collector capacitance at  $f = 1 \text{ MHz}$**

$I_E = I_e = 0; V_{CB} = 13.5 \text{ V}$	$C_c$	2N3924	2N3926	2N3927
$C_c <$	20	20	45 pF	

**Transition frequency**

$I_C = 100 \text{ mA}; V_{CE} = 13.5 \text{ V}$	$f_T >$	2N3924	2N3926	2N3927
$f_T >$	250	250	MHz	
$I_C = 200 \text{ mA}; V_{CE} = 13.5 \text{ V}$	$f_T >$		200	MHz

**Real part of input impedance at  $f = 200 \text{ MHz}$**

$I_C = 100 \text{ mA}; V_{CE} = 13.5 \text{ V}$	$Re(h_{ie}) <$	2N3924	2N3926	2N3927
$Re(h_{ie}) <$	20	20	$\Omega$	
$I_C = 200 \text{ mA}; V_{CE} = 13.5 \text{ V}$	$Re(h_{ie}) <$		20	$\Omega$

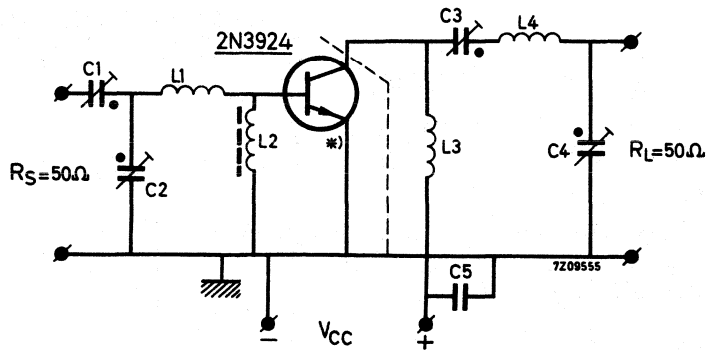
**R.F. performance at  $V_{CE} = 13.5 \text{ V}; f = 175 \text{ MHz}$**

	$P_o$ (W)	$P_i$ (W)	$I_C$ (mA)	$\eta$ %	Test circuit
2N3924	4	< 1	< 420	> 70	I
2N3926	7	< 2	< 740	> 70	II
2N3927	12	< 4	< 1100	> 80	II

**NOTE**

The transistors can withstand an output V.S.W.R. of 3:1 varied through all phases under conditions mentioned in the table above.

## CHARACTERISTICS (continued)

Test circuit I (with the 2N3924 at  $f = 175$  MHz)

\*) The length of the external emitter wire of the 2N3924 is 1.6 mm.

## Components

$C1 = C2 = C3 = C4 = 4$  to  $29$  pF      air trimmer

$C5 =$                                        $10$  nF      polyester

$L1 = 1$  turn Cu wire ( $1.0$  mm); int. diam.  $10$  mm; leads  $2 \times 10$  mm

$L2 =$  Ferroxcube choke coil.  $Z$  (at  $f = 175$  MHz) =  $550 \Omega \pm 20\%$

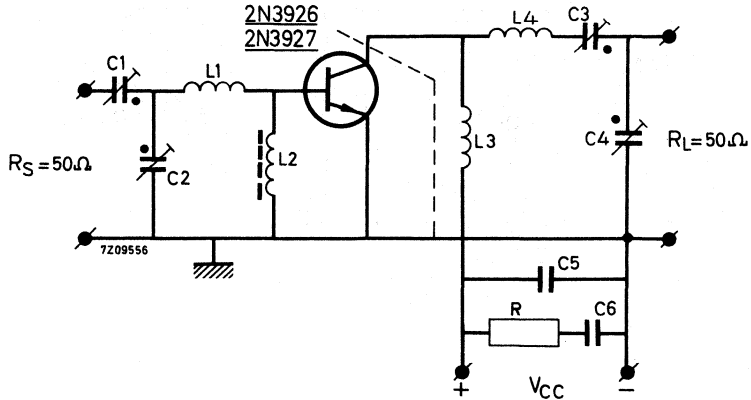
(code number 4312 020 36640)

$L3 = 15$  turns closely wound enamelled Cu wire ( $0.7$  mm); int. diam.  $4$  mm

$L4 = 3$  turns closely wound enamelled Cu wire ( $1.5$  mm); int. diam.  $12$  mm; leads  $2 \times 20$  mm

**CHARACTERISTICS** (continued)

Test circuit II (with the 2N3926 or 2N3927 at  $f = 175 \text{ MHz}$ )



**Components**

C1 = C2 = C3 = C4 = 4 to 29 pF      air trimmer

C5 =                                      100 pF      ceramic

C6 =                                      10 nF      polyester

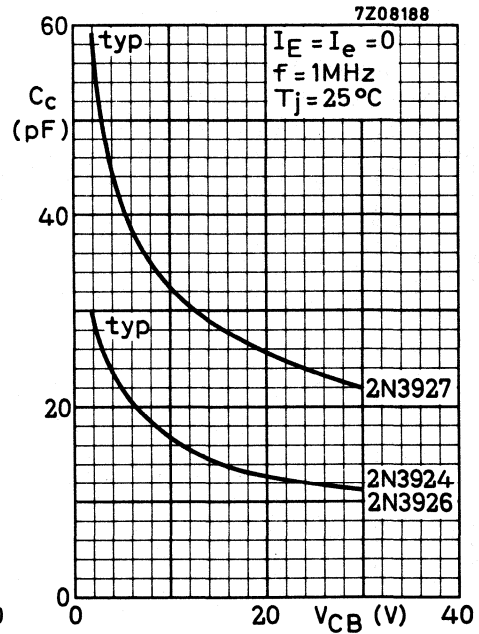
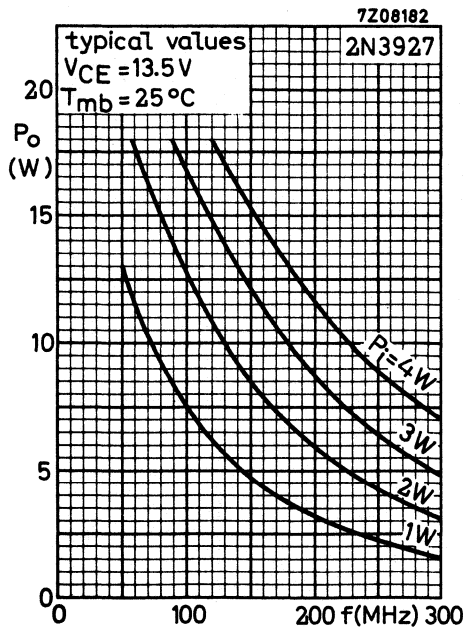
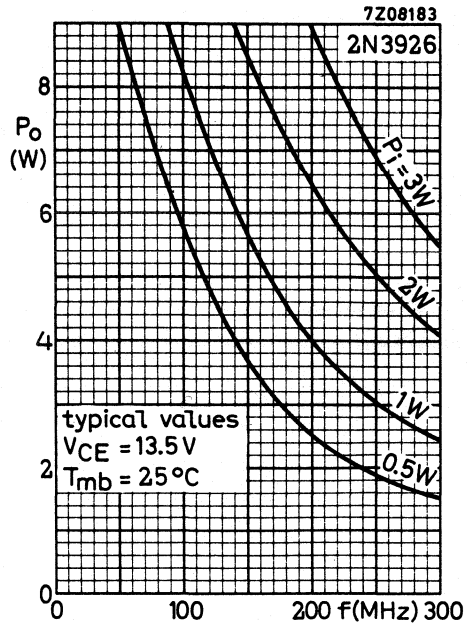
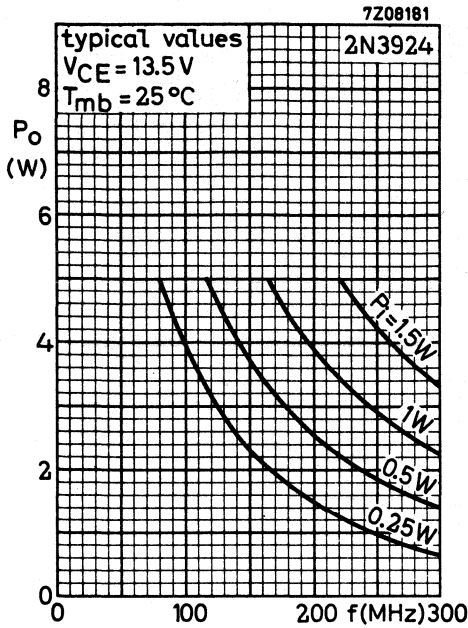
L1 = 1 turn Cu wire (1.0 mm); int. diam. 10 mm; leads 2 x 10 mm

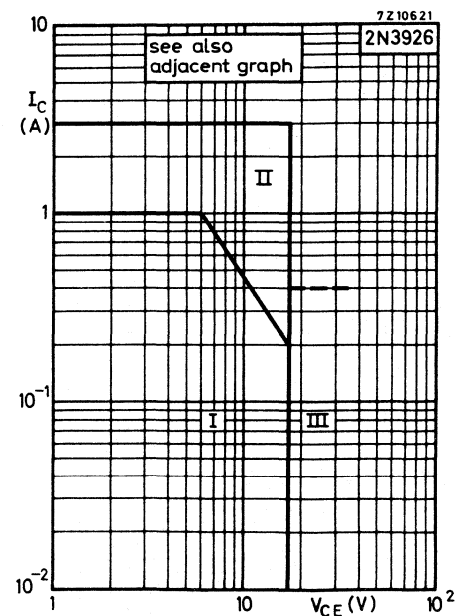
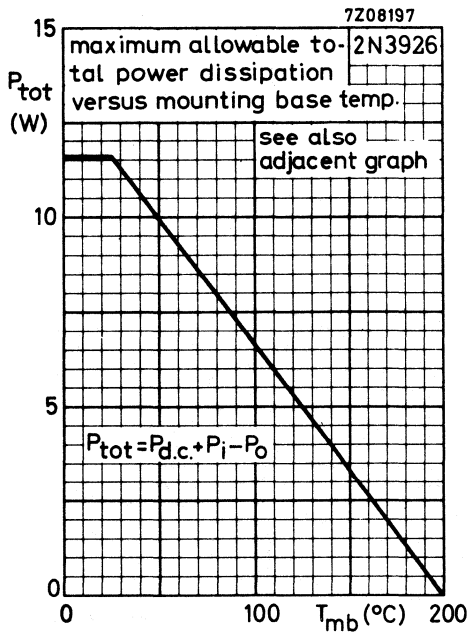
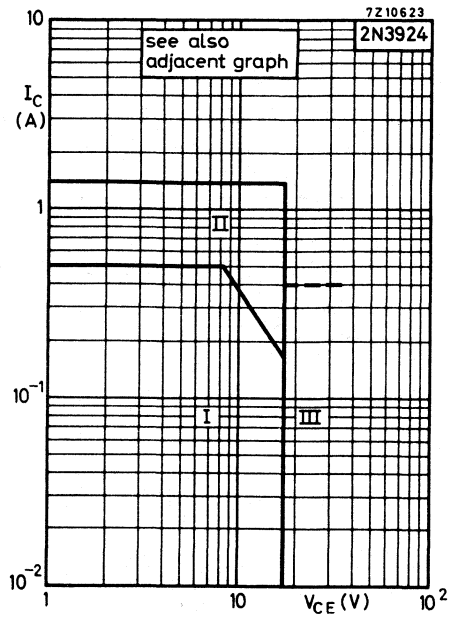
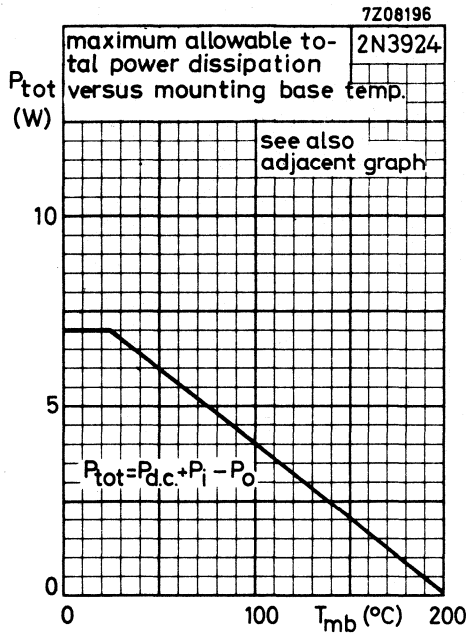
L2 = Ferroxcube choke coil.  $Z$  (at  $f = 175 \text{ MHz}$ ) =  $550 \Omega \pm 20\%$   
(code number 4312 020 36640)

L3 = 15 turns closely wound enamelled Cu wire (0.7 mm); int. diam. 4 mm

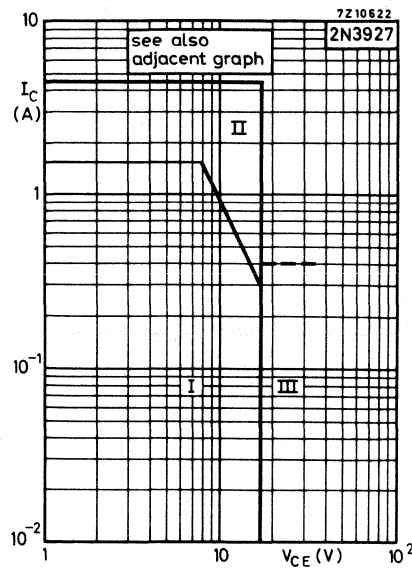
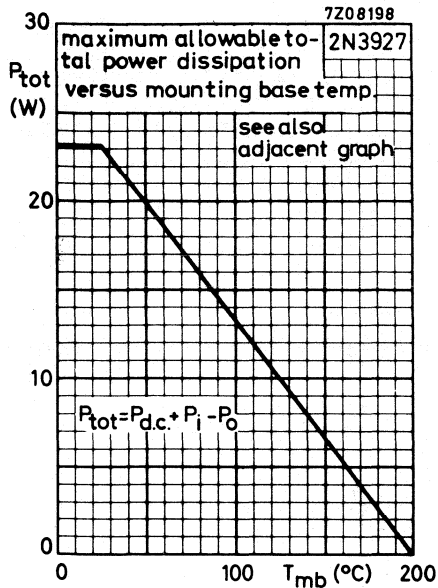
L4 = 2 turns closely wound enamelled Cu wire (1.5 mm); int. diam. 8.5 mm; leads  
2 x 20 mm

R = 10  $\Omega$       carbon



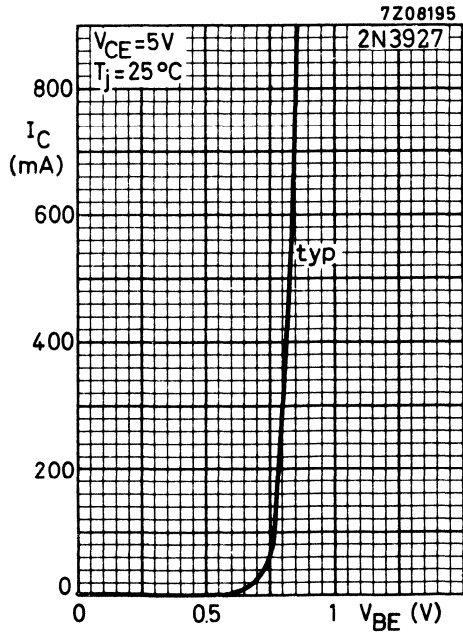
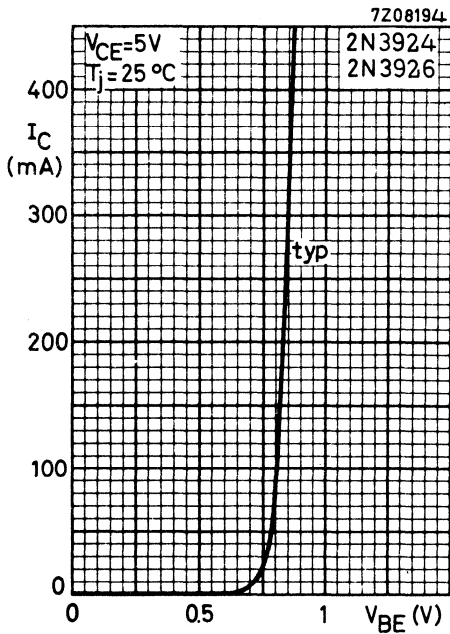
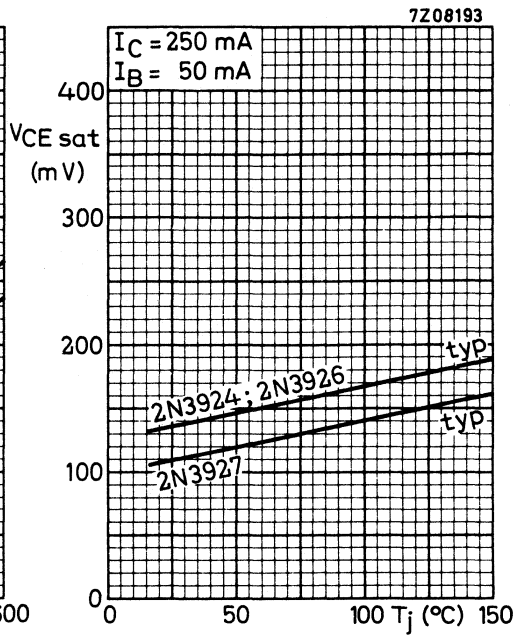
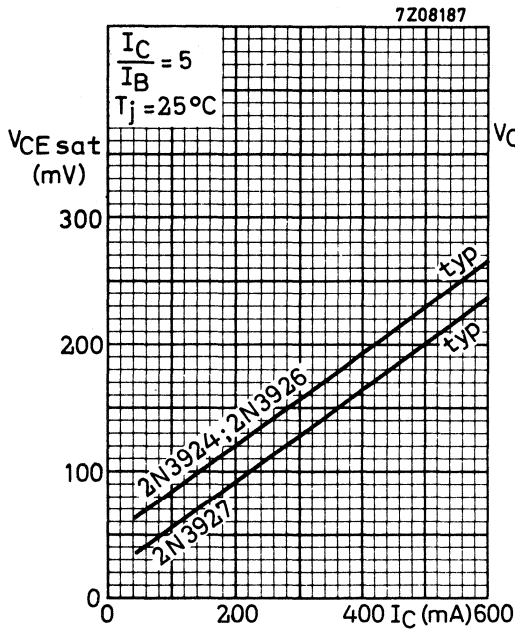


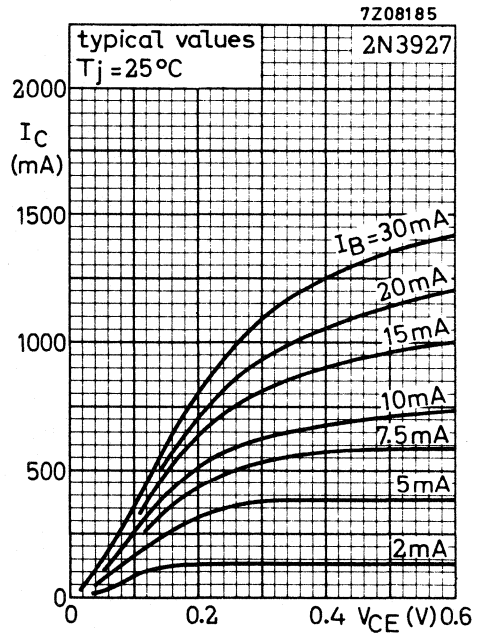
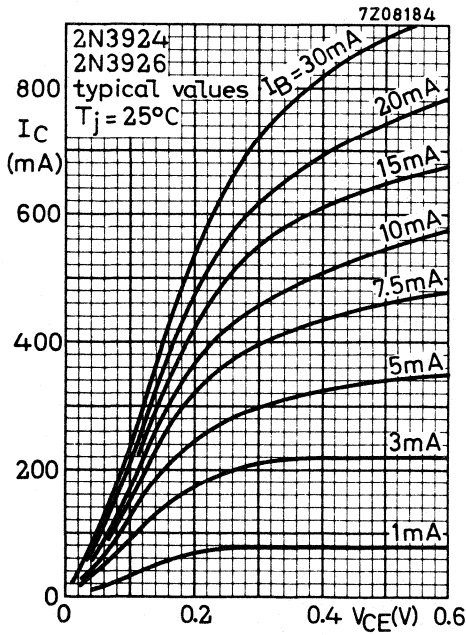
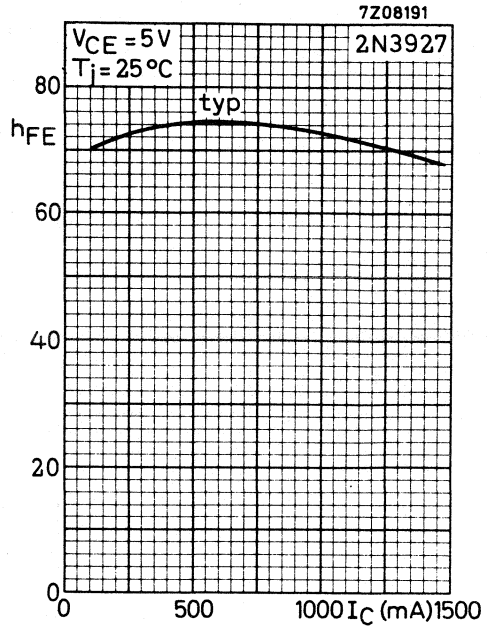
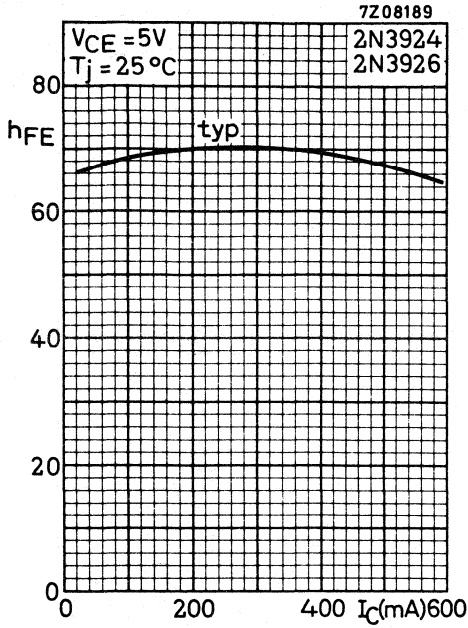




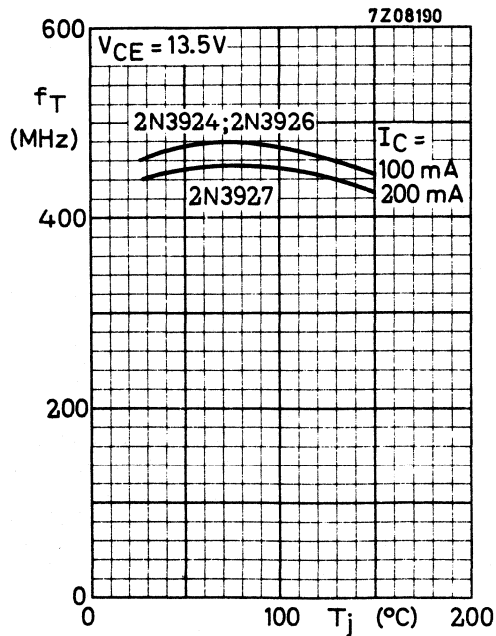
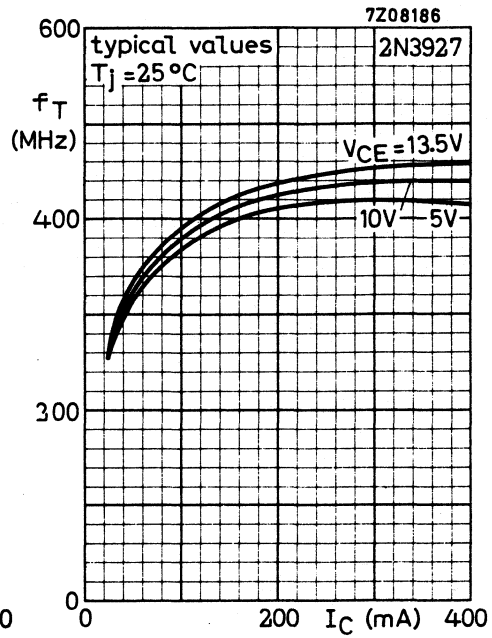
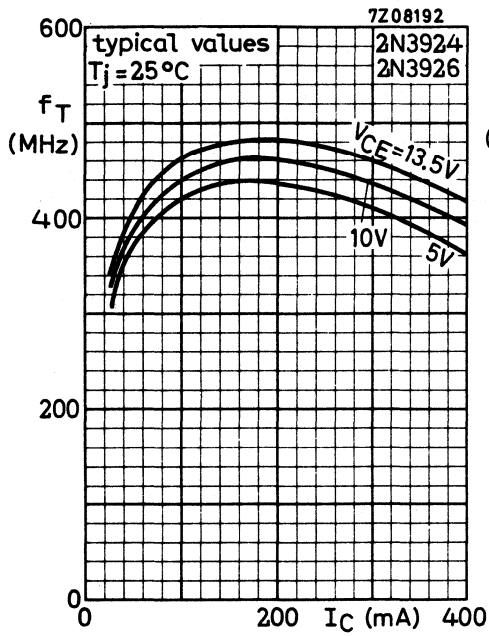
- I Region of permissible operation under all base-emitter conditions and at all frequencies, including d.c.
- II Additional region of operation at  $f \geq 1$  MHz.  
Care must be taken to reduce the d.c. adjustment to region I before removing the a.c. signal. This may be achieved by an appropriate bias in class A, B or C.
- III Operating during switching off in this region is allowed, provided the transistor is cut-off with  $-V_{BE} \leq 1.5$  V and  $R_{BE} \geq 33 \Omega$ ,  $I_C \leq 400$  mA and the transient energy does not exceed 2 mWs.

2N3924  
2N3926  
2N3927





2N3924  
2N3926  
2N3927



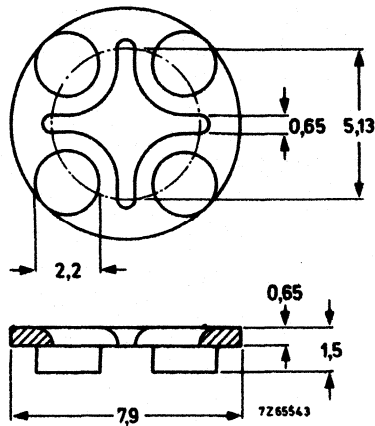
## ACCESSORIES



56245

## MECHANICAL DATA

Dimensions in mm



(Distance disc) for TO-39.

Insulating material.

Maximum permissible temperature 100 °C.





## INDEX OF TYPENUMBERS



**INDEX OF TYPE NUMBERS**

The inclusion of a type number in this publication does not necessarily imply its availability.

**Key to handbook sections**

A	=	Accessories
FET	=	Field-effect transistors
I	=	Infrared devices
LED	=	Light-emitting diodes
LCD	=	Liquid crystal displays
Mm	=	Surface-mounted devices
M	=	Microwave transistors
P	=	Low-frequency power transistors and modules
PDT	=	Photodiodes or transistors
Ph	=	Photoconductive devices
PhC	=	Photocouplers
PM	=	Power MOS transistors
R	=	Rectifier diodes
RFP	=	RF power transistors and modules
RT	=	Triplers
Sen	=	Semiconductor sensors
SD	=	Small-signal diodes
Sm	=	Small-signal transistors
Sp	=	Special diodes
SP	=	Low-frequency switching power diodes
St	=	Rectifier stacks
T	=	Tuner diodes
Th	=	Thyristors
Tri	=	Triacs
TS	=	Transient suppressor diodes
Vrf	=	Voltage reference diodes
Vrg	=	Voltage regulator diodes
WBT	=	Wideband hybrid IC transistors
WBM	=	Wideband hybrid IC modules.

\* series.

TYPE NUMBER	BOOK	SECTION
BA220	SC01	SD
BA221	SC01	SD
BA223	SC01	T
BA281	SC01	SD
BA314	SC01	Vrg
BA315	SC01	Vrg
BA316	SC01	SD
BA317	SC01	SD
BA318	SC01	SD
BA423	SC01	T
BA423L	SC01/10	T/Mm
BA480	SC01	T
BA481	SC01	T
BA482	SC01	T
BA483	SC01	T
BA484	SC01	T
BA682	SC01/10	T/Mm
BA683	SC01/10	T/Mm
BAS11	SC01	SD
BAS15	SC01	SD
BAS16	SC01/10	SD/Mm
BAS17	SC01/10	Vrg/Mm
BAS19	SC01/10	SD/Mm
BAS20	SC01/10	SD/Mm
BAS21	SC01/10	SD/Mm
BAS28	SC01/10	SD/Mm
BAS29	SC01/10	SD/Mm
BAS31	SC01/10	SD/Mm
BAS32	SC01/10	SD/Mm
BAS32L	SC01/10	SD/Mm
BAS35	SC01/10	SD/Mm
BAS45	SC01	SD
BAS45L	SC01/10	SD/Mm
BAS56	SC01/10	SD/Mm
BAS85	SC01/10	SD/Mm
BAS86	SC01/10	SD/Mm
BAT17	SC01/10	T/Mm
BAT18	SC01/10	T/Mm
BAT54	SC01/10	SD/Mm
BAT54A	SC01/10	SD/Mm

TYPE NUMBER	BOOK	SECTION
BAT54C	SC01/10	SD/Mm
BAT54S	SC01/10	SD/Mm
BAT74	SC01/10	SD/Mm
BAT81	SC01	T
BAT82	SC01	T
BAT83	SC01	T
BAT85	SC01	T
BAT86	SC01	T
BAV10	SC01	SD
BAV18	SC01	SD
BAV19	SC01	SD
BAV20	SC01	SD
BAV21	SC01	SD
BAV23	SC01/10	SD/Mm
BAV45	SC01	Sp
BAV70	SC01/10	SD/Mm
BAV74	SC01/10	SD/Mm
BAV99	SC01/10	SD/Mm
BAV100	SC01/10	SD/Mm
BAV101	SC01/10	SD/Mm
BAV102	SC01/10	SD/Mm
BAV103	SC01/10	SD/Mm
BAV105	SC01/10	SD/Mm
BAW56	SC01/10	SD/Mm
BAW62	SC01	SD
BAX12	SC01	SD
BAX14	SC01	SD
BAX18	SC01	SD
BAY80	SC01	SD
BB112	SC01	T
BB119	SC01	T
BB130	SC01	T
BB204B	SC01	T
BB204G	SC01	T
BB212	SC01	T
BB215	SC01/10	SD/Mm
BB219	SC01/10	SD/Mm
BB240	SC01/10	T/Mm
BB241	SC01/10	T/Mm
BB249	SC01/10	T/Mm

TYPE NUMBER	BOOK	SECTION
BB405B	SC01	T
BB417	SC01	T
BB804	SC01/10	T/Mm
BB809	SC01	T
BB909A	SC01	T
BB909B	SC01	T
BB910	SC01	T
BB911	SC01	T
BBY31	SC01/10	T/Mm
BBY39	SC01/10	T/Mm
BBY40	SC01/10	T/Mm
BBY42	SC01/10	T/Mm
BBY62	SC01/10	T/Mm
BC107	SC04	Sm
BC108	SC04	Sm
BC109	SC04	Sm
BC140	SC04	Sm
BC141	SC04	Sm
BC160	SC04	Sm
BC161	SC04	Sm
BC177	SC04	Sm
BC178	SC04	Sm
BC179	SC04	Sm
BC264A	SC07	FET
BC264B	SC07	FET
BC246C	SC07	FET
BC264D	SC07	FET
BC327	SC04	Sm
BC327A	SC04	Sm
BC328	SC04	Sm
BC337	SC04	Sm
BC337A	SC04	Sm
BC338	SC04	Sm
BC368	SC04	Sm
BC369	SC04	Sm
BC375	SC04	Sm
BC376	SC04	Sm
BC516	SC04	Sm
BC517	SC04	Sm
BC546	SC04	Sm

TYPE NUMBER	BOOK	SECTION
BC547	SC04	Sm
BC548	SC04	Sm
BC549	SC04	Sm
BC550	SC04	Sm
BC556	SC04	Sm
BC557	SC04	Sm
BC558	SC04	Sm
BC559	SC04	Sm
BC560	SC04	Sm
BC617	SC04	Sm
BC618	SC04	Sm
BC635	SC04	Sm
BC636	SC04	Sm
BC637	SC04	Sm
BC638	SC04	Sm
BC639	SC04	Sm
BC640	SC04	Sm
BC807	SC10	Mm
BC808	SC10	Mm
BC817	SC10	Mm
BC818	SC10	Mm
BC846	SC10	Mm
BC847	SC10	Mm
BC848	SC10	Mm
BC849	SC10	Mm
BC850	SC10	Mm
BC856	SC10	Mm
BC857	SC10	Mm
BC858	SC10	Mm
BC859	SC10	Mm
BC860	SC10	Mm
BC868	SC10	Mm
BC869	SC10	Mm
BC875	SC04	Sm
BC876	SC04	Sm
BC877	SC04	Sm
BC878	SC04	Sm
BC879	SC04	Sm
BC880	SC04	Sm
BCF29	SC10	Mm

TYPE NUMBER	BOOK	SECTION
BCF29R	SC10	Mm
BCF30	SC10	Mm
BCF30R	SC10	Mm
BCF32	SC10	Mm
BCF32R	SC10	Mm
BCF33	SC10	Mm
BCF33R	SC10	Mm
BCF70	SC10	Mm
BCF70R	SC10	Mm
BCF81	SC10	Mm
BCF81R	SC10	Mm
BCP51	SC10	Mm
BCP52	SC10	Mm
BCP53	SC10	Mm
BCP54	SC10	Mm
BCP55	SC10	Mm
BCP56	SC10	Mm
BCP68	SC10	Mm
BCP69	SC10	Mm
BCV26	SC10	Mm
BCV27	SC10	Mm
BCV28	SC10	Mm
BCV29	SC10	Mm
BCV46	SC10	Mm
BCV47	SC10	Mm
BCV48	SC10	Mm
BCV49	SC10	Mm
BCV61	SC10	Mm
BCV62	SC10	Mm
BCV63	SC10	Mm
BCV64	SC10	Mm
BCV65	SC10	Mm
BCV71	SC10	Mm
BCV71R	SC10	Mm
BCV72	SC10	Mm
BCV72R	SC10	Mm
BCW29	SC10	Mm
BCW29R	SC10	Mm
BCW30	SC10	Mm
BCW30R	SC10	Mm

TYPE NUMBER	BOOK	SECTION
BCW31	SC10	Mm
BCW31R	SC10	Mm
BCW32	SC10	Mm
BCW32R	SC10	Mm
BCW33	SC10	Mm
BCW33R	SC10	Mm
BCW60*	SC10	Mm
BCW61*	SC10	Mm
BCW69	SC10	Mm
BCW69R	SC10	Mm
BCW70	SC10	Mm
BCW70R	SC10	Mm
BCW71	SC10	Mm
BCW71R	SC10	Mm
BCW72	SC10	Mm
BCW72R	SC10	Mm
BCW81	SC10	Mm
BCW81R	SC10	Mm
BCW89	SC10	Mm
BCW89R	SC10	Mm
BCX17	SC10	Mm
BCX17R	SC10	Mm
BCX18	SC10	Mm
BCX18R	SC10	Mm
BCX19	SC10	Mm
BCX19R	SC10	Mm
BCX20	SC10	Mm
BCX20R	SC10	Mm
BCX22	SC04	Sm
BCX23	SC04	Sm
BCX51	SC10	Mm
BCX52	SC10	Mm
BCX53	SC10	Mm
BCX54	SC10	Mm
BCX55	SC10	Mm
BCX56	SC10	Mm
BCX58	SC04	Sm
BCX59	SC04	Sm
BCX70*	SC10	Mm
BCX71*	SC10	Mm

TYPE NUMBER	BOOK	SECTION
BCX78	SC04	Sm
BCX79	SC04	Sm
BCY56	SC04	Sm
BCY57	SC04	Sm
BCY58	SC04	Sm
BCY59	SC04	Sm
BCY65	SC04	Sm
BCY70	SC04	Sm
BCY71	SC04	Sm
BCY72	SC04	Sm
BCY78	SC04	Sm
BCY79	SC04	Sm
BCY87	SC04	Sm
BCY88	SC04	Sm
BCY89	SC04	Sm
BD131	SC05	P
BD132	SC05	P
BD135	SC05	P
BD136	SC05	P
BD137	SC05	P
BD138	SC05	P
BD139	SC05	P
BD140	SC05	P
BD201	SC05	P
BD201F	SC05	P
BD202	SC05	P
BD202F	SC05	P
BD203	SC05	P
BD203F	SC05	P
BD204	SC05	P
BD204F	SC05	P
BD226	SC05	P
BD227	SC05	P
BD228	SC05	P
BD229	SC05	P
BD230	SC05	P
BD231	SC05	P
BD233	SC05	P
BD234	SC05	P
BD235	SC05	P

TYPE NUMBER	BOOK	SECTION
BD236	SC05	P
BD237	SC05	P
BD238	SC05	P
BD239	SC05	P
BD239A	SC05	P
BD239B	SC05	P
BD239C	SC05	P
BD240	SC05	P
BD240A	SC05	P
BD240B	SC05	P
BD240C	SC05	P
BD241	SC05	P
BD241A	SC05	P
BD241B	SC05	P
BD241C	SC05	P
BD242	SC05	P
BD242A	SC05	P
BD242B	SC05	P
BD242C	SC05	P
BD243	SC05	P
BD243A	SC05	P
BD243B	SC05	P
BD243C	SC05	P
BD244	SC05	P
BD244A	SC05	P
BD244B	SC05	P
BD244C	SC05	P
BD329	SC05	P
BD330	SC05	P
BD331	SC05	P
BD332	SC05	P
BD333	SC05	P
BD334	SC05	P
BD335	SC05	P
BD336	SC05	P
BD337	SC05	P
BD338	SC05	P
BD433	SC05	P
BD434	SC05	P
BD435	SC05	P

TYPE NUMBER	BOOK	SECTION
BD436	SC05	P
BD437	SC05	P
BD438	SC05	P
BD643	SC05	P
BD643F	SC05	P
BD644	SC05	P
BD644F	SC05	P
BD645	SC05	P
BD645F	SC05	P
BD646	SC05	P
BD646F	SC05	P
BD647	SC05	P
BD647F	SC05	P
BD648	SC05	P
BD648F	SC05	P
BD649	SC05	P
BD649F	SC05	P
BD650	SC05	P
BD650F	SC05	P
BD651	SC05	P
BD651F	SC05	P
BD652	SC05	P
BD652F	SC05	P
BD675	SC05	P
BD676	SC05	P
BD677	SC05	P
BD678	SC05	P
BD679	SC05	P
BD680	SC05	P
BD681	SC05	P
BD682	SC05	P
BD683	SC05	P
BD684	SC05	P
BD719	SC05	P
BD720	SC05	P
BD721	SC05	P
BD722	SC05	P
BD723	SC05	P
BD724	SC05	P
BD725	SC05	P

TYPE NUMBER	BOOK	SECTION
BD726	SC05	P
BD825	SC05	P
BD826	SC05	P
BD827	SC05	P
BD828	SC05	P
BD829	SC05	P
BD830	SC05	P
BD839	SC05	P
BD840	SC05	P
BD841	SC05	P
BD842	SC05	P
BD843	SC05	P
BD844	SC05	P
BD933	SC05	P
BD933F	SC05	P
BD934	SC05	P
BD934F	SC05	P
BD935	SC05	P
BD935F	SC05	P
BD936	SC05	P
BD936F	SC05	P
BD937	SC05	P
BD937F	SC05	P
BD938	SC05	P
BD938F	SC05	P
BD939	SC05	P
BD939F	SC05	P
BD940	SC05	P
BD940F	SC05	P
BD941	SC05	P
BD941F	SC05	P
BD942	SC05	P
BD942F	SC05	P
BD943	SC05	P
BD943F	SC05	P
BD944	SC05	P
BD944F	SC05	P
BD945	SC05	P
BD945F	SC05	P
BD946	SC05	P



TYPE NUMBER	BOOK	SECTION
BD946F	SC05	P
BD947	SC05	P
BD947F	SC05	P
BD948	SC05	P
BD948F	SC05	P
BD949	SC05	P
BD949F	SC05	P
BD950	SC05	P
BD950F	SC05	P
BD951	SC05	P
BD951F	SC05	P
BD952	SC05	P
BD952F	SC05	P
BD953	SC05	P
BD953F	SC05	P
BD954	SC05	P
BD954F	SC05	P
BD955	SC05	P
BD955F	SC05	P
BD956	SC05	P
BD956F	SC05	P
BDS60	SC05/10	P/Mm
BDS60A	SC05/10	P/Mm
BDS60B	SC05/10	P/Mm
BDS60C	SC05/10	P/Mm
BDS61	SC05/10	P/Mm
BDS61A	SC05/10	P/Mm
BDS61B	SC05/10	P/Mm
BDS61C	SC05/10	P/Mm
BDX77	SC05/10	P/Mm
BDX78	SC05/10	P/Mm
BDS201	SC05/10	P/Mm
BDS202	SC05/10	P/Mm
BDS203	SC05/10	P/Mm
BDS204	SC05/10	P/Mm
BDS643	SC05/10	P/Mm
BDS644	SC05/10	P/Mm
BDS645	SC05/10	P/Mm
BDS646	SC05/10	P/Mm
BDS647	SC05/10	P/Mm

TYPE NUMBER	BOOK	SECTION
BDS648	SC05/10	P/Mm
BDS649	SC05/10	P/Mm
BDS650	SC05/10	P/Mm
BDS651	SC05/10	P/Mm
BDS652	SC05/10	P/Mm
BDS933	SC05/10	P/Mm
BDS934	SC05/10	P/Mm
BDS935	SC05/10	P/Mm
BDS936	SC05/10	P/Mm
BDS937	SC05/10	P/Mm
BDS938	SC05/10	P/Mm
BDS939	SC05/10	P/Mm
BDS940	SC05/10	P/Mm
BDS941	SC05/10	P/Mm
BDS942	SC05/10	P/Mm
BDS943	SC05/10	P/Mm
BDS944	SC05/10	P/Mm
BDS945	SC05/10	P/Mm
BDS946	SC05/10	P/Mm
BDS947	SC05/10	P/Mm
BDS948	SC05/10	P/Mm
BDS950	SC05/10	P/Mm
BDS951	SC05/10	P/Mm
BDS952	SC05/10	P/Mm
BDT29	SC05/10	P/Mm
BDT29F	SC05	P
BDT29A	SC05	P
BDT29AF	SC05	P
BDT29B	SC05	P
BDT29BF	SC05	P
BDT29C	SC05	P
BDT29CF	SC05	P
BDT30	SC05	P
BDT30F	SC05	P
BDT30A	SC05	P
BDT30AF	SC05	P
BDT30B	SC05	P
BDT30BF	SC05	P
BDT30C	SC05	P
BDT30CF	SC05	P

TYPE NUMBER	BOOK	SECTION
BDT31	SC05	P
BDT31F	SC05	P
BDT31A	SC05	P
BDT31AF	SC05	P
BDT31B	SC05	P
BDT31BF	SC05	P
BDT31C	SC05	P
BDT31CF	SC05	P
BDT31D	SC05	P
BDT31DF	SC05	P
BDT32	SC05	P
BDT32F	SC05	P
BDT32A	SC05	P
BDT32AF	SC05	P
BDT32B	SC05	P
BDT32BF	SC05	P
BDT32C	SC05	P
BDT32CF	SC05	P
BDT32D	SC05	P
BDT32DF	SC05	P
BDT41A	SC05	P
BDT41AF	SC05	P
BDT41B	SC05	P
BDT41BF	SC05	P
BDT41C	SC05	P
BDT41CF	SC05	P
BDT42	SC05	P
BDT42F	SC05	P
BDT42A	SC05	P
BDT42AF	SC05	P
BDT42B	SC05	P
BDT42BF	SC05	P
BDT42C	SC05	P
BDT42CF	SC05	P
BDT60	SC05	P
BDT60F	SC05	P
BDT60A	SC05	P
BDT60AF	SC05	P
BDT60B	SC05	P
BDT60BF	SC05	P

TYPE NUMBER	BOOK	SECTION
BDT60C	SC05	P
BDT60CF	SC05	P
BDT61	SC05	P
BDT61F	SC05	P
BDT61A	SC05	P
BDT61AF	SC05	P
BDT61B	SC05	P
BDT61BF	SC05	P
BDT61C	SC05	P
BDT61CF	SC05	P
BDT62	SC05	P
BDT62F	SC05	P
BDT62A	SC05	P
BDT62AF	SC05	P
BDT62B	SC05	P
BDT62BF	SC05	P
BDT62C	SC05	P
BDT62CF	SC05	P
BDT63	SC05	P
BDT63F	SC05	P
BDT63A	SC05	P
BDT63AF	SC05	P
BDT63B	SC05	P
BDT63BF	SC05	P
BDT63C	SC05	P
BDT63CF	SC05	P
BDT64	SC05	P
BDT64F	SC05	P
BDT64A	SC05	P
BDT64AF	SC05	P
BDT64B	SC05	P
BDT64BF	SC05	P
BDT64C	SC05	P
BDT64CF	SC05	P
BDT65	SC05	P
BDT65F	SC05	P
BDT65A	SC05	P
BDT65AF	SC05	P
BDT65B	SC05	P
BDT65BF	SC05	P

TYPE NUMBER	BOOK	SECTION
BDT65C	SC05	P
BDT65CF	SC05	P
BDT81	SC05	P
BDT81F	SC05	P
BDT82	SC05	P
BDT82F	SC05	P
BDT83	SC05	P
BDT83F	SC05	P
BDT84	SC05	P
BDT84F	SC05	P
BDT85	SC05	P
BDT85F	SC05	P
BDT86	SC05	P
BDT86F	SC05	P
BDT87	SC05	P
BDT87F	SC05	P
BDT88	SC05	P
BDT88F	SC05	P
BDT91	SC05	P
BDT91F	SC05	P
BDT92	SC05	P
BDT92F	SC05	P
BDT93	SC05	P
BDT93F	SC05	P
BDT94	SC05	P
BDT94F	SC05	P
BDT95	SC05	P
BDT95F	SC05	P
BDT96	SC05	P
BDT96F	SC05	P
BDV64	SC05	P
BDV64A	SC05	P
BDV64B	SC05	P
BDV64C	SC05	P
BDV65	SC05	P
BDV65A	SC05	P
BDV65B	SC05	P
BDV65C	SC05	P
BDV66A	SC05	P
BDV66B	SC05	P

TYPE NUMBER	BOOK	SECTION
BDV66C	SC05	P
BDV66D	SC05	P
BDV67A	SC05	P
BDV67B	SC05	P
BDV67C	SC05	P
BDV67D	SC05	P
BDV91	SC05	P
BDV92	SC05	P
BDV93	SC05	P
BDV94	SC05	P
BDV95	SC05	P
BDV96	SC05	P
BDX35	SC05	P
BDX36	SC05	P
BDX37	SC05	P
BDX42	SC05	P
BDX43	SC05	P
BDX44	SC05	P
BDX45	SC05	P
BDX46	SC05	P
BDX47	SC05	P
BDX62	SC05	P
BDX62A	SC05	P
BDX62B	SC05	P
BDX62C	SC05	P
BDX63	SC05	P
BDX63A	SC05	P
BDX63B	SC05	P
BDX63C	SC05	P
BDX64	SC05	P
BDX64A	SC05	P
BDX64B	SC05	P
BDX64C	SC05	P
BDX65	SC05	P
BDX65A	SC05	P
BDX65B	SC05	P
BDX65C	SC05	P
BDX66	SC05	P
BDX66A	SC05	P
BDX66B	SC05	P

TYPE NUMBER	BOOK	SECTION
BDX66C	SC05	P
BDX67	SC05	P
BDX67A	SC05	P
BDX67B	SC05	P
BDX67C	SC05	P
BDX68	SC05	P
BDX68A	SC05	P
BDX68B	SC05	P
BDX68C	SC05	P
BDX69	SC05	P
BDX69A	SC05	P
BDX69B	SC05	P
BDX69C	SC05	P
BDX77	SC05	P
BDX77F	SC05	P
BDX78	SC05	P
BDX78F	SC05	P
BDX91	SC05	P
BDX92	SC05	P
BDX93	SC05	P
BDX94	SC05	P
BDX95	SC05	P
BDX96	SC05	P
BDY90	SC05	P
BDY91	SC05	P
BDY92	SC05	P
BF198	SC04	Sm
BF199	SC04	Sm
BF240	SC04	Sm
BF241	SC04	Sm
BF245A	SC07	FET
BF245B	SC07	FET
BF245C	SC07	FET
BF246A	SC07	FET
BF246B	SC07	FET
BF246C	SC07	FET
BF247A	SC07	FET
BF247B	SC07	FET
BF247C	SC07	FET
BF256A	SC07	FET

TYPE NUMBER	BOOK	SECTION
BF256B	SC07	FET
BF256C	SC07	FET
BF324	SC04	Sm
BF370	SC04	Sm
BF410A	SC07	FET
BF410B	SC07	FET
BF410C	SC07	FET
BF410D	SC07	FET
BF420	SC04	Sm
BF421	SC04	Sm
BF422	SC04	Sm
BF423	SC04	Sm
BF450	SC04	Sm
BF451	SC04	Sm
BF483	SC04	Sm
BF485	SC04	Sm
BF486	SC04	Sm
BF487	SC04	Sm
BF488	SC04	Sm
BF494	SC04	Sm
BF495	SC04	Sm
BF496	SC04	Sm
BF510	SC07/10	FET/Mm
BF511	SC07/10	FET/Mm
BF512	SC07/10	FET/Mm
BF513	SC07/10	FET/Mm
BF550	SC10	Mm
BF550R	SC10	Mm
BF569	SC10	Mm
BF570	SC10	Mm
BF579	SC10	Mm
BF620	SC10	Mm
BF621	SC10	Mm
BF622	SC10	Mm
BF623	SC10	Mm
BF660	SC10	Mm
BF660R	SC10	Mm
BF689K	SC14	WBT
BF720	SC10	Mm
BF721	SC10	Mm

TYPE NUMBER	BOOK	SECTION
BF722	SC10	Mm
BF723	SC10	Mm
BF747	SC14/10	WBT/Mm
BF763	SC14	WBT
BF820	SC10	Mm
BF821	SC10	Mm
BF822	SC10	Mm
BF823	SC10	Mm
BF824	SC10	Mm
BF840	SC10	Mm
BF841	SC10	Mm
BF926	SC04	Sm
BF960	SC07	FET
BF964S	SC07	FET
BF965	SC07	FET
BF966S	SC07	FET
BF970	SC04	Sm
BF970A	SC04	Sm
BF979	SC04	Sm
BF980A	SC07	FET
BF981	SC07	FET
BF982	SC07	FET
BF988	SC07/10	FET/Mm
BF989	SC07/10	FET/Mm
BF990A	SC07/10	FET/Mm
BF990AR	SC07/10	FET/Mm
BF991	SC07/10	FET/Mm
BF992	SC07/10	FET/Mm
BF992R	SC07/10	FET/Mm
BF994S	SC07/10	FET/Mm
BF996S	SC07/10	FET/Mm
BF997	SC07/10	FET/Mm
BF998	SC07/10	FET/Mm
BF998R	SC07/10	FET/Mm
BFG16A	SC14/10	WBT/Mm
BFG17A	SC14/10	WBT/Mm
BFG23	SC14	WBT
BFG25AX	SC14/10	WBT/Mm
BFG31	SC14/10	WBT/Mm
BFG32	SC14	WBT

TYPE NUMBER	BOOK	SECTION
BFG33	SC14/10	WBT/Mm
BFG33X	SC14/10	WBT/Mm
BFG34	SC14	WBT
BFG35	SC14/10	WBT/Mm
BFG51	SC14	WBT
BFG65	SC14	WBT
BFG67	SC14/10	WBT/Mm
BFG67X	SC14/10	WBT/Mm
BFG90A	SC14	WBT
BFG91A	SC14	WBT
BFG92A	SC14/10	WBT/Mm
BFG92AX	SC14/10	WBT/Mm
BFG93A	SC14/10	WBT/Mm
BFG93AX	SC14/10	WBT/Mm
BFG94	SC14/10	WBT/Mm
BFG96	SC14	WBT
BFG97	SC14/10	WBT/Mm
BFG135	SC14/10	WBT/Mm
BFG195	SC14	WBT
BFG197	SC14/10	WBT/Mm
BFG197X	SC14/10	WBT/Mm
BFG198	SC14/10	WBT/Mm
BFP90A	SC14	WBT
BFP91A	SC14	WBT
BFP96	SC14	WBT
BFQ10	SC07	FET
BFQ11	SC07	FET
BFQ12	SC07	FET
BFQ13	SC07	FET
BFQ14	SC07	FET
BFQ15	SC07	FET
BFQ16	SC07	FET
BFQ17	SC14/10	WBT/Mm
BFQ18A	SC14/10	WBT/Mm
BFQ19	SC14/10	WBT/Mm
BFQ22S	SC14	WBT
BFQ23	SC14	WBT
BFQ23C	SC14	WBT
BFQ24	SC14	WBT
BFQ32	SC14	WBT

TYPE NUMBER	BOOK	SECTION
BFQ32C	SC14	WBT
BFQ32M	SC14	WBT
BFQ32S	SC14	WBT
BFQ33	SC14	WBT
BFQ33C	SC14	WBT
BFQ34	SC14	WBT
BFQ34T	SC14	WBT
BFQ42	SC08a	RFP
BFQ43	SC08a	RFP
BFQ43S	SC08a	RFP
BFQ51	SC14	WBT
BFQ51C	SC14	WBT
BFQ52	SC14	WBT
BFQ53	SC14	WBT
BFQ63	SC14	WBT
BFQ65	SC14	WBT
BFQ66	SC14	WBT
BFQ67	SC14/10	WBT/Mm
BFQ68	SC14	WBT
BFQ135	SC14	WBT
BFQ136	SC14	WBT
BFQ149	SC14/10	WBT/Mm
BFQ161	SC14	WBT
BFQ162	SC14	WBT
BFQ163	SC14	WBT
BFQ231	SC14	WBT
BFQ231A	SC14	WBT
BFQ232	SC14	WBT
BFQ232A	SC14	WBT
BFQ233	SC14	WBT
BFQ233A	SC14	WBT
BFQ234	SC14	WBT
BFQ235	SC14	WBT
BFQ235A	SC14	WBT
BFQ251	SC14	WBT
BFQ251A	SC14	WBT
BFQ252	SC14	WBT
BFQ252A	SC14	WBT
BFQ253	SC14	WBT
BFQ253A	SC14	WBT

TYPE NUMBER	BOOK	SECTION
BFQ254	SC14	WBT
BFQ255	SC14	WBT
BFQ255A	SC14	WBT
BFQ262	SC14	WBT
BFQ262A	SC14	WBT
BFQ263	SC14	WBT
BFQ263A	SC14	WBT
BFQ265	SC14	WBT
BFQ265A	SC14	WBT
BFQ268	SC14	WBT
BFQ270	SC14	WBT
BFR29	SC07	FET
BFR30	SC07/10	FET/Mm
BFR31	SC07/10	FET/Mm
BFR49	SC14	WBT
BFR53	SC14/10	WBT/Mm
BFR54	SC04	Sm
BFR64	SC14	WBT
BFR65	SC14	WBT
BFR84	SC07	FET
BFR90	SC14	WBT
BFR90A	SC14	WBT
BFR91	SC14	WBT
BFR91A	SC14	WBT
BFR92	SC14/10	WBT/Mm
BFR92A	SC14/10	WBT/Mm
BFR93	SC14/10	WBT/Mm
BFR93A	SC14/10	WBT/Mm
BFR94	SC14	WBT
BFR95	SC14	WBT
BFR96	SC14	WBT
BFR96S	SC14	WBT
BFR106	SC14/10	WBT/Mm
BFR101A	SC07/10	FET/Mm
BFR101B	SC07/10	FET/Mm
BFR134	SC14	WBT
BFR200	SC07/10	FET/Mm
BFS17	SC14/10	WBT
BFS17A	SC14	WBT
BFS18	SC10	Mm

TYPE NUMBER	BOOK	SECTION
BFS18R	SC10	Mm
BFS19	SC10	Mm
BFS19R	SC10	Mm
BFS20	SC10	Mm
BFS20R	SC10	Mm
BFS21	SC07	FET
BFS21A	SC07	FET
BFS22A	SC08a	RFP
BFS23A	SC08a	RFP
BFT24	SC14	WBT
BFT25	SC14/10	WBT/Mm
BFT25A	SC14	WBT
BFT44	SC04	Sm
BFT45	SC04	Sm
BFT46	SC07/10	FET/Mm
BFT92	SC14/10	WBT/Mm
BFT93	SC14/10	WBT/Mm
BFW10	SC07	FET
BFW11	SC07	FET
BFW12	SC07	FET
BFW13	SC07	FET
BFW16A	SC14	WBT
BFW17A	SC14	WBT
BFW30	SC14	WBT
BFW61	SC07	FET
BFW92	SC14	WBT
BFW92A	SC14	WBT
BFW93	SC14	WBT
BFX29	SC04	Sm
BFX30	SC04	Sm
BFX34	SC04	Sm
BFX84	SC04	Sm
BFX85	SC04	Sm
BFX87	SC04	Sm
BFX88	SC04	Sm
BFX89	SC14	WBT
BFY50	SC04	Sm
BFY51	SC04	Sm
BFY52	SC04	Sm
BFY55	SC04	Sm

TYPE NUMBER	BOOK	SECTION
BFY90	SC14	WBT
BG2000	SC01	RT
BG2097	SC01	RT
BGD102	SC14	WBM
BGD102E	SC14	WBM
BGD104	SC14	WBM
BGD104E	SC14	WBM
BGD106	SC14	WBM
BGD108	SC14	WBM
BGD502	SC14	WBM
BGD504	SC14	WBM
BGD506	SC14	WBM
BGD508	SC14	WBM
BGE85A	SC14	WBM
BGE88	SC14	WBM
BGE88-01	SC14	WBM
BGE885	SC14	WBM
BGE887	SC14	WBM
BGX885	SC14	WBM
BGY22	SC09	RFP
BGY22A	SC09	RFP
BGY23	SC09	RFP
BGY23A	SC09	RFP
BGY32	SC09	RFP
BGY33	SC09	RFP
BGY35	SC09	RFP
BGY36	SC09	RFP
BGY40A	SC09	RFP
BGY40B	SC09	RFP
BGY41A	SC09	RFP
BGY41B	SC09	RFP
BGY43	SC09	RFP
BGY45A	SC09	RFP
BGY45B	SC09	RFP
BGY45C	SC09	RFP
BGY46A	SC09	RFP
BGY46B	SC09	RFP
BGY47A	SC09	RFP
BGY47F	SC09	RFP
BGY48A	SC09	RFP

TYPE NUMBER	BOOK	SECTION
BGY48B	SC09	RFP
BGY48C	SC09	RFP
BGY49A	SC09	RFP
BGY49B	SC09	RFP
BGY50	SC14	WBM
BGY51	SC14	WBM
BGY52	SC14	WBM
BGY53	SC14	WBM
BGY54	SC14	WBM
BGY55	SC14	WBM
BGY56	SC14	WBM
BGY57	SC14	WBM
BGY58	SC14	WBM
BGY58A	SC14	WBM
BGY59	SC14	WBM
BGY60	SC14	WBM
BGY61	SC14	WBM
BGY65	SC14	WBM
BGY67	SC14	WBM
BGY67A	SC14	WBM
BGY70	SC14	WBM
BGY71	SC14	WBM
BGY74	SC14	WBM
BGY75	SC14	WBM
BGY78	SC14	WBM
BGY80	SC14	WBM
BGY81	SC14	WBM
BGY82	SC14	WBM
BGY83	SC14	WBM
BGY84	SC14	WBM
BGY84A	SC14	WBM
BGY85	SC14	WBM
BGY85A	SC14	WBM
BGY85H	SC14	WBM
BGY85H/01	SC14	WBM
BGY86	SC14	WBM
BGY87	SC14	WBM
BGY87B	SC14	WBM
BGY88	SC14	WBM
BGY90A	SC09	RFP

TYPE NUMBER	BOOK	SECTION
BGY90B	SC09	RFP
BGY91A	SC09	RFP
BGY91B	SC09	RFP
BGY93A	SC09	RFP
BGY93B	SC09	RFP
BGY93C	SC09	RFP
BGY94A	SC09	RFP
BGY94B	SC09	RFP
BGY94C	SC09	RFP
BGY95A	SC09	RFP
BGY95B	SC09	RFP
BGY96A	SC09	RFP
BGY96B	SC09	RFP
BGY110A	SC09	RFP
BGY110B	SC09	RFP
BGY580	SC14	WBM
BGY581	SC14	WBM
BGY582	SC14	WBM
BGY583	SC14	WBM
BGY584	SC14	WBM
BGY584A	SC14	WBM
BGY585	SC14	WBM
BGY585A	SC14	WBM
BGY586	SC14	WBM
BGY587	SC14	WBM
BGY587B	SC14	WBM
BGY588	SC14	WBM
BLF145	SC08b	RFP/FET
BLF147	SC08b	RFP/FET
BLF175	SC08b	RFP/FET
BLF177	SC08b	RFP/FET
BLF221	SC08b	RFP/FET
BLF225	SC08b	RFP/FET
BLF241	SC08b	RFP/FET
BLF242	SC08b	RFP/FET
BLF244	SC08b	RFP/FET
BLF245	SC08b	RFP/FET
BLF245B	SC08b	RFP/FET
BLF246	SC08b	RFP/FET
BLF246B	SC08b	RFP/FET



TYPE NUMBER	BOOK	SECTION	TYPE NUMBER	BOOK	SECTION
BLF277	SC08b	RFP/FET	BLV20	SC08a	RFP
BLF278	SC08b	RFP/FET	BLV21	SC08a	RFP
BLF346	SC08b	RFP/FET	BLV25	SC08a	RFP
BLF348	SC08b	RFP/FET	BLV30	SC08a	RFP
BLF368	SC08b	RFP/FET	BLV31	SC08a	RFP
BLF378	SC08b	RFP/FET	BLV32F	SC08a	RFP
BLF521	SC08b	RFP/FET	BLV33	SC08a	RFP
BLF522	SC08b	RFP/FET	BLV33F	SC08a	RFP
BLF543	SC08b	RFP/FET	BLV36	SC08a	RFP
BLF544	SC08b	RFP/FET	BLV37	SC08a	RFP
BLF544B	SC08b	RFP/FET	BLV38	SC08a	RFP
BLF545	SC08b	RFP/FET	BLV45/12	SC08a	RFP
BLF546	SC08b	RFP/FET	BLV57	SC08a	RFP
BLF548	SC08b	RFP/FET	BLV59	SC08a	RFP
BLT50	SC08a	RFP	BLV75/12	SC08a	RFP
BLT80	SC08a	RFP	BLV80/28	SC08a	RFP
BLT90/SL	SC08a	RFP	BLV90	SC08a	RFP
BLT91/SL	SC08a	RFP	BLV90/SL	SC08a	RFP
BLT92/SL	SC08a	RFP	BLV91	SC08a	RFP
BLT93/SL	SC08a	RFP	BLV91/SL	SC08a	RFP
BLU11/SL	SC08a	RFP	BLV92	SC08a	RFP
BLU15/12	SC08a	RFP	BLV93	SC08a	RFP
BLU20/12	SC08a	RFP	BLV94	SC08a	RFP
BLU30/12	SC08a	RFP	BLV95	SC08a	RFP
BLU30/28	SC08a	RFP	BLV97	SC08a	RFP
BLU45/12	SC08a	RFP	BLV97CE	SC08a	RFP
BLU50	SC08a	RFP	BLV98	SC08a	RFP
BLU51	SC08a	RFP	BLV98CE	SC08a	RFP
BLU52	SC08a	RFP	BLV99	SC08a	RFP
BLU53	SC08a	RFP	BLV100	SC08a	RFP
BLU56	SC08a	RFP	BLV101A	SC08a	RFP
BLU60/12	SC08a	RFP	BLV101B	SC08a	RFP
BLU60/28	SC08a	RFP	BLW29	SC08a	RFP
BLU86	SC08a	RFP	BLW30	SC08a	RFP
BLU97	SC08a	RFP	BLW31	SC08a	RFP
BLU98	SC08a	RFP	BLW32	SC08a	RFP
BLU99	SC08a	RFP	BLW33	SC08a	RFP
BLV10	SC08a	RFP	BLW34	SC08a	RFP
BLV11	SC08a	RFP	BLW50F	SC08a	RFP
BLV12	SC08a	RFP	BLW60	SC08a	RFP

TYPE NUMBER	BOOK	SECTION
BLW60C	SC08a	RFP
BLW76	SC08a	RFP
BLW77	SC08a	RFP
BLW78	SC08a	RFP
BLW79	SC08a	RFP
BLW80	SC08a	RFP
BLW81	SC08a	RFP
BLW83	SC08a	RFP
BLW84	SC08a	RFP
BLW85	SC08a	RFP
BLW86	SC08a	RFP
BLW87	SC08a	RFP
BLW89	SC08a	RFP
BLW90	SC08a	RFP
BLW91	SC08a	RFP
BLW95	SC08a	RFP
BLW96	SC08a	RFP
BLW97	SC08a	RFP
BLW98	SC08a	RFP
BLW99	SC08a	RFP
BLX13	SC08a	RFP
BLX13C	SC08a	RFP
BLX14	SC08a	RFP
BLX15	SC08a	RFP
BLX39	SC08a	RFP
BLX65	SC08a	RFP
BLX65E	SC08a	RFP
BLX65ES	SC08a	RFP
BLX67	SC08a	RFP
BLX68	SC08a	RFP
BLX69A	SC08a	RFP
BLX91A	SC08a	RFP
BLX91CB	SC08a	RFP
BLX92A	SC08a	RFP
BLX93A	SC08a	RFP
BLX94A	SC08a	RFP
BLX94C	SC08a	RFP
BLX95	SC08a	RFP
BLX96	SC08a	RFP
BLX97	SC08a	RFP

TYPE NUMBER	BOOK	SECTION
BLX98	SC08a	RFP
BLY87A	SC08a	RFP
BLY87C	SC08a	RFP
BLY87C/01	SC08a	RFP
BLY88A	SC08a	RFP
BLY88C	SC08a	RFP
BLY88C/01	SC08a	RFP
BLY89A	SC08a	RFP
BLY89C	SC08a	RFP
BLY90	SC08a	RFP
BLY91A	SC08a	RFP
BLY91C	SC08a	RFP
BLY92A	SC08a	RFP
BLY92C	SC08a	RFP
BLY93A	SC08a	RFP
BLY93C	SC08a	RFP
BLY94	SC08a	RFP
BR100/03	SC03	Th
BR101	SC04	Sm
BR210*	SC02	R
BR211*	SC02	R
BR213*	SC02	R
BR216*	SC02	R
BR220*	SC02	R
BRY39	SC04	Sm
BRY56	SC04	Sm
BRY61	SC10	Mm
BRY62	SC10	Mm
BS107	SC07	FET
BS107A	SC07	FET
BS170	SC07	FET
BS208	SC07	FET
BS250	SC07	FET
BSD12	SC07	FET
BSD22	SC07/10	FET/M
BSD212	SC07	FET
BSD213	SC07	FET
BSD214	SC07	FET
BSD215	SC07	FET
BSN204	SC07	FET

TYPE NUMBER	BOOK	SECTION
BSN204A	SC07	FET
BSN205	SC07	FET
BSN205A	SC07	FET
BSN254	SC07	FET
BSN254A	SC07	FET
BSN274	SC07	FET
BSN274A	SC07	FET
BSP15	SC10	Mm
BSP16	SC10	Mm
BSP19	SC10	Mm
BSP20	SC10	Mm
BSP30	SC10	Mm
BSP31	SC10	Mm
BSP32	SC10	Mm
BSP33	SC10	Mm
BSP40	SC10	Mm
BSP41	SC10	Mm
BSP42	SC10	Mm
BSP43	SC10	Mm
BSP50	SC10	Mm
BSP51	SC10	Mm
BSP52	SC10	Mm
BSP60	SC10	Mm
BSP61	SC10	Mm
BSP62	SC10	Mm
BSP103	SC07/10	FET/Mm
BSP105	SC07/10	FET/Mm
BSP106	SC07/10	FET/Mm
BSP107	SC07/10	FET/Mm
BSP108	SC07/10	FET/Mm
BSP109	SC07/10	FET/Mm
BSP110	SC07/10	FET/Mm
BSP120	SC07/10	FET/Mm
BSP121	SC07/10	FET/Mm
BSP126	SC07/10	FET/Mm
BSP204	SC07	FET
BSP204A	SC07	FET
BSP205	SC07/10	FET/Mm
BSP206	SC07/10	FET/Mm
BSP220	SC07	FET

TYPE NUMBER	BOOK	SECTION
BSP225	SC07/10	FET/Mm
BSP254	SC07	FET
BSP254A	SC07	FET
BSR12	SC10	Mm
BSR12R	SC10	Mm
BSR13	SC10	Mm
BSR13R	SC10	Mm
BSR14	SC10	Mm
BSR14R	SC10	Mm
BSR15	SC10	Mm
BSR15R	SC10	Mm
BSR16	SC10	Mm
BSR16R	SC10	Mm
BSR17	SC10	Mm
BSR17R	SC10	Mm
BSR17A	SC10	Mm
BSR17AR	SC10	Mm
BSR18	SC10	Mm
BSR18R	SC10	Mm
BSR18A	SC10	Mm
BSR18AR	SC10	Mm
BSR19	SC10	Mm
BSR19A	SC10	Mm
BSR20	SC10	Mm
BSR20A	SC10	Mm
BSR30	SC10	Mm
BSR31	SC10	Mm
BSR32	SC10	Mm
BSR33	SC10	Mm
BSR40	SC10	Mm
BSR41	SC10	Mm
BSR42	SC10	Mm
BSR43	SC10	Mm
BSR50	SC04	Sm
BSR51	SC04	Sm
BSR52	SC04	Sm
BSR56	SC07/10	FET/Mm
BSR57	SC07/10	FET/Mm
BSR58	SC07/10	FET/Mm
BSR60	SC04	Sm

TYPE NUMBER	BOOK	SECTION
BSR61	SC04	Sm
BSR62	SC04	Sm
BSS38	SC04	Sm
BSS50	SC04	Sm
BSS51	SC04	Sm
BSS52	SC04	Sm
BSS60	SC04	Sm
BSS61	SC04	Sm
BSS62	SC04	Sm
BSS63	SC10	Mm
BSS63R	SC10	Mm
BSS64	SC10	Mm
BSS64R	SC10	Mm
BSS68	SC04	Sm
BSS83	SC07/10	FET/Mm
BSS84	SC07/10	FET/Mm
BSS87	SC07/10	FET/Mm
BSS89	SC07	FET
BSS91	SC07	FET
BSS92	SC07	FET
BSS100	SC07	FET
BSS123	SC07	FET
BSS131	SC07	FET
BSS138	SC07	FET
BSS192	SC07/10	FET/Mm
BST15	SC10	Mm
BST16	SC10	Mm
BST39	SC10	Mm
BST40	SC10	Mm
BST50	SC10	Mm
BST51	SC10	Mm
BST52	SC10	Mm
BST60	SC10	Mm
BST61	SC10	Mm
BST62	SC10	Mm
BST70A	SC07	FET
BST72A	SC07	FET
BST74A	SC07	FET
BST76A	SC07	FET
BST78	SC07	FET

TYPE NUMBER	BOOK	SECTION
BST80	SC07/10	FET/Mm
BST82	SC07/10	FET/Mm
BST84	SC07/10	FET/Mm
BST86	SC07/10	FET/Mm
BST95	SC07	FET
BST97	SC07	FET
BST100	SC07	FET
BST110	SC07	FET
BST120	SC07/10	FET/Mm
BST122	SC07/10	FET/Mm
BSV15	SC04	Sm
BSV16	SC04	Sm
BSV17	SC04	Sm
BSV52	SC10	Mm
BSV52R	SC10	Mm
BSV64	SC04	Sm
BSV78	SC07	FET
BSV79	SC07	FET
BSV80	SC07	FET
BSV81	SC07	FET
BSW66A	SC04	Sm
BSW67A	SC04	Sm
BSW68A	SC04	Sm
BSX19	SC04	Sm
BSX20	SC04	Sm
BSX32	SC04	Sm
BSX45	SC04	Sm
BSX46	SC04	Sm
BSX47	SC04	Sm
BSX59	SC04	Sm
BSX60	SC04	Sm
BSX61	SC04	Sm
BSX62	SC04	Sm
BSX63	SC04	Sm
BSY95A	SC04	Sm
BT134*	SC03	Tri
BT134W*	SC03	Tri
BT136*	SC03	Tri
BT136F*	SC03	Tri
BT137*	SC03	Tri

TYPE NUMBER	BOOK	SECTION	TYPE NUMBER	BOOK	SECTION
BT137F*	SC03	Tri	BU824	SC06	SP
BT138*	SC03	Tri	BU826	SC06	SP
BT138F*	SC03	Tri	BUP22*	SC06	SP
BT139*	SC03	Tri	BUP23*	SC06	SP
BT139F*	SC03	Tri	BUS11	SC06	SP
BT145*	SC03	Tri	BUS11A	SC06	SP
BT148*	SC03	Th	BUS12	SC06	SP
BT149*	SC03	Th	BUS12A	SC06	SP
BT150	SC03	Th	BUS13	SC06	SP
BT151*	SC03	Th	BUS13A	SC06	SP
BT151F*	SC03	Th	BUS14	SC06	SP
BT152*	SC03	Th	BUS14A	SC06	SP
BT153	SC03	Th	BUS21*	SC06	SP
BT169*	SC03	Th	BUS22*	SC06	SP
BT169W*	SC03	Th	BUS23*	SC06	SP
BTA140*	SC03	Tri	BUS24*	SC06	SP
BTR59*	SC03	Tri	BUS131*	SC06	SP
BTS59*	SC03	Tri	BUS132*	SC06	SP
BTV58*	SC03	Th	BUS133*	SC06	SP
BTW38*	SC03	Th	BUT11	SC06	SP
BTW40*	SC03	Th	BUT11A	SC06	SP
BTW42*	SC03	Th	BÜT11F	SC06	SP
BTW43*	SC03	Tri	BUT11AF	SC06	SP
BTW45*	SC03	Th	BUT12	SC06	SP
BTW58*	SC03	Th	BUT12A	SC06	SP
BTY79*	SC03	Th	BUT12F	SC06	SP
BTY91*	SC03	Th	BUT12AF	SC06	SP
BU306	SC06	SP	BUT18	SC06	SP
BU306F	SC06	SP	BUT18A	SC06	SP
BU505	SC06	SP	BUT18F	SC06	SP
BU506	SC06	SP	BUT18AF	SC06	SP
BU506D	SC06	SP	BUT21B	SC06	SP
BU508A	SC06	SP	BUT21C	SC06	SP
BU508D	SC06	SP	BUT21BF	SC06	SP
BU705	SC06	SP	BUT21CF	SC06	SP
BU706	SC06	SP	BUT22B	SC06	SP
BU706D	SC06	SP	BUT22C	SC06	SP
BU806	SC06	SP	BUT22BF	SC06	SP
BU807	SC06	SP	BUT22CF	SC06	SP
BU808	SC06	SP	BUT131	SC06	SP

TYPE NUMBER	BOOK	SECTION
BUV26	SC06	SP
BUV26A	SC06	SP
BUV26F	SC06	SP
BUV26AF	SC06	SP
BUV27	SC06	SP
BUV27A	SC06	SP
BUV27F	SC06	SP
BUV27AF	SC06	SP
BUV28	SC06	SP
BUV28A	SC06	SP
BUV28F	SC06	SP
BUV28AF	SC06	SP
BUV47	SC06	SP
BUV47A	SC06	SP
BUV48	SC06	SP
BUV48A	SC06	SP
BUV82	SC06	SP
BUV83	SC06	SP
BUV89	SC06	SP
BUV90	SC06	SP
BUV90F	SC06	SP
BUV98(V)	SC06	SP
BUV98A	SC06	SP
BUV298(V)	SC06	SP
BUV298A	SC06	SP
BUW11	SC06	SP
BUW11A	SC06	SP
BUW12	SC06	SP
BUW12A	SC06	SP
BUW12F	SC06	SP
BUW12AF	SC06	SP
BUW13	SC06	SP
BUW13A	SC06	SP
BUW13F	SC06	SP
BUW13AF	SC06	SP
BUW84	SC06	SP
BUW85	SC06	SP
BUW86	SC06	SP
BUW87	SC06	SP
BUW87A	SC06	SP

TYPE NUMBER	BOOK	SECTION
BUW131*	SC06	SP
BUW132*	SC06	SP
BUW133*	SC06	SP
BUX46	SC06	SP
BUX46A	SC06	SP
BUX47	SC06	SP
BUX47A	SC06	SP
BUX48	SC06	SP
BUX48A	SC06	SP
BUX84	SC06	SP
BUX84F	SC06	SP
BUX85	SC06	SP
BUX85F	SC06	SP
BUX86	SC06	SP
BUX87	SC06	SP
BUX88	SC06	SP
BUX98	SC06	SP
BUX98A	SC06	SP
BUX99	SC06	SP
BUY89	SC06	SP
BUK416-100AE/BE	SC13	PM
BUK416-200AE/BE	SC13	PM
BUK416-1000AE/BE	SC13	PM
BUK417-500AE/BE	SC13	PM
BUK426-60A/B	SC13	PM
BUK426-100A/B	SC13	PM
BUK426-200A/B	SC13	PM
BUK426-800A/B	SC13	PM
BUK426-1000A/B	SC13	PM
BUK427-400A/B	SC13	PM
BUK427-500A/B	SC13	PM
BUK427-600A/B	SC13	PM
BUK428-500A/B	SC13	PM
BUK428-800A/B	SC13	PM
BUK428-1000A/B	SC13	PM
BUK436-60A/B	SC13	PM
BUK436-100A/B	SC13	PM
BUK436-200A/B	SC13	PM
BUK436-800A/B	SC13	PM
BUK436-1000A/B	SC13	PM

TYPE NUMBER	BOOK	SECTION
BUK437-400A/B	SC13	PM
BUK437-500A/B	SC13	PM
BUK437-600A/B	SC13	PM
BUK438-500A/B	SC13	PM
BUK438-800A/B	SC13	PM
BUK438-1000A/B	SC13	PM
BUK439-60A	SC13	PM
BUK441-60A/B	SC13	PM
BUK441-100A/B	SC13	PM
BUK442-60A/B	SC13	PM
BUK442-100A/B	SC13	PM
BUK443-60A/B	SC13	PM
BUK443-100A/B	SC13	PM
BUK444-200A/B	SC13	PM
BUK444-400A/B	SC13	PM
BUK444-500A/B	SC13	PM
BUK444-600A/B	SC13	PM
BUK444-800A/B	SC13	PM
BUK445-60A/B	SC13	PM
BUK445-100A/B	SC13	PM
BUK445-200A/B	SC13	PM
BUK445-400A/B	SC13	PM
BUK445-500A/B	SC13	PM
BUK445-600A/B	SC13	PM
BUK446-800A/B	SC13	PM
BUK446-1000A/B	SC13	PM
BUK451-60A/B	SC13	PM
BUK451-100A/B	SC13	PM
BUK452-60A/B	SC13	PM
BUK452-100A/B	SC13	PM
BUK453-60A	SC13	PM
BUK453-60B	SC13	PM
BUK453-100A	SC13	PM
BUK453-100B	SC13	PM
BUK453-500A	SC13	PM
BUK453-500B	SC13	PM
BUK454-200A	SC13	PM
BUK454-200B	SC13	PM
BUK454-400A	SC13	PM
BUK454-400B	SC13	PM

TYPE NUMBER	BOOK	SECTION
BUK454-500A	SC13	PM
BUK454-500B	SC13	PM
BUK454-600A	SC13	PM
BUK454-600B	SC13	PM
BUK454-800A	SC13	PM
BUK454-800B	SC13	PM
BUK455-60A	SC13	PM
BUK455-60B	SC13	PM
BUK455-100A	SC13	PM
BUK455-100B	SC13	PM
BUK455-200A	SC13	PM
BUK455-200B	SC13	PM
BUK455-400A	SC13	PM
BUK455-400B	SC13	PM
BUK455-500A	SC13	PM
BUK455-500B	SC13	PM
BUK455-600A	SC13	PM
BUK455-600B	SC13	PM
BUK456-60A	SC13	PM
BUK456-60B	SC13	PM
BUK456-100A	SC13	PM
BUK456-100B	SC13	PM
BUK456-200A	SC13	PM
BUK456-200B	SC13	PM
BUK456-800A	SC13	PM
BUK456-800B	SC13	PM
BUK456-1000A	SC13	PM
BUK456-1000B	SC13	PM
BUK457-400A	SC13	PM
BUK457-400B	SC13	PM
BUK457-500A	SC13	PM
BUK457-500B	SC13	PM
BUK457-600B	SC13	PM
BUK471-60A*	SC13	PM
BUK471-60B*	SC13	PM
BUK471-100A*	SC13	PM
BUK471-100B*	SC13	PM
BUK472-60A*	SC13	PM
BUK472-60B*	SC13	PM
BUK472-100A*	SC13	PM

TYPE NUMBER	BOOK	SECTION
BUK472-100B'	SC13	PM
BUK473-60A'	SC13	PM
BUK473-60B'	SC13	PM
BUK473-100A'	SC13	PM
BUK473-100B'	SC13	PM
BUK474-200A'	SC13	PM
BUK474-200B'	SC13	PM
BUK474-400A'	SC13	PM
BUK474-400B'	SC13	PM
BUK474-500A'	SC13	PM
BUK474-500B'	SC13	PM
BUK474-600A'	SC13	PM
BUK474-600B'	SC13	PM
BUK474-800A'	SC13	PM
BUK474-800B'	SC13	PM
BUK475-60A'	SC13	PM
BUK475-60B'	SC13	PM
BUK475-100A'	SC13	PM
BUK475-100B'	SC13	PM
BUK475-200A'	SC13	PM
BUK475-200B'	SC13	PM
BUK475-400A'	SC13	PM
BUK475-400B'	SC13	PM
BUK475-500A'	SC13	PM
BUK475-500B'	SC13	PM
BUK475-600A'	SC13	PM
BUK475-600B'	SC13	PM
BUK476-800A'	SC13	PM
BUK476-800B'	SC13	PM
BUK476-1000A'	SC13	PM
BUK476-1000B'	SC13	PM
BUK539-60A'	SC13	PM
BUK541-60A'	SC13	PM
BUK541-60B'	SC13	PM
BUK541-100A	SC13	PM
BUK541-100B	SC13	PM
BUK542-60A	SC13	PM
BUK542-60B	SC13	PM
BUK542-100A	SC13	PM
BUK542-100B	SC13	PM

TYPE NUMBER	BOOK	SECTION
BUK543-60A	SC13	PM
BUK543-60B	SC13	PM
BUK543-100A	SC13	PM
BUK543-100B	SC13	PM
BUK545-60A	SC13	PM
BUK545-60B	SC13	PM
BUK545-100A	SC13	PM
BUK545-100B	SC13	PM
BUK545-200A	SC13	PM
BUK545-200B	SC13	PM
BUK551-60A'	SC13	PM
BUK551-60B'	SC13	PM
BUK551-100A	SC13	PM
BUK551-100B	SC13	PM
BUK552-60A	SC13	PM
BUK552-60B	SC13	PM
BUK552-100A	SC13	PM
BUK552-100B	SC13	PM
BUK553-60A	SC13	PM
BUK553-60B	SC13	PM
BUK553-100A	SC13	PM
BUK553-100B	SC13	PM
BUK554-200A	SC13	PM
BUK554-200B	SC13	PM
BUK555-60A	SC13	PM
BUK555-60B	SC13	PM
BUK555-100A'	SC13	PM
BUK555-100B	SC13	PM
BUK555-200A	SC13	PM
BUK555-200B	SC13	PM
BUK556-60A'	SC13	PM
BUK571-60A'	SC13	PM
BUK571-60A'	SC13	PM
BUK571-60B'	SC13	PM
BUK571-100A'	SC13	PM
BUK571-100B'	SC13	PM
BUK572-60A'	SC13	PM
BUK572-60B'	SC13	PM
BUK572-100A'	SC13	PM
BUK572-100B'	SC13	PM



TYPE NUMBER	BOOK	SECTION
BUK573-60A*	SC13	PM
BUK573-60B*	SC13	PM
BUK573-100A*	SC13	PM
BUK573-100B*	SC13	PM
BUK575-60A*	SC13	PM
BUK575-60B*	SC13	PM
BUK575-100A*	SC13	PM
BUK575-100B*	SC13	PM
BUK575-200A*	SC13	PM
BUK575-200B*	SC13	PM
BUK617-500AE	SC13	PM
BUK617-500BE	SC13	PM
BUK627-500A	SC13	PM
BUK627-500B	SC13	PM
BUK637-400A	SC13	PM
BUK637-400B	SC13	PM
BUK637-500A	SC13	PM
BUK637-500B	SC13	PM
BUK638-500A	SC13	PM
BUK638-500B	SC13	PM
BUK638-800A*	SC13	PM
BUK638-800B*	SC13	PM
BUK638-1000A*	SC13	PM
BUK638-1000B*	SC13	PM
BUK655-500A	SC13	PM
BUK655-500B	SC13	PM
BUK657-400A	SC13	PM
BUK657-400B	SC13	PM
BUK657-500A	SC13	PM
BUK657-500B	SC13	PM
BUK793-60A*	SC13	PM
BUK795-60A*	SC13	PM
BUK993-60A*	SC13	PM
BUK995-60A*	SC13	PM
BUZ308	SC13	PM
BUZ310	SC13	PM
BUZ311	SC13	PM
BUZ326	SC13	PM
BUZ330	SC13	PM
BUZ331	SC13	PM

TYPE NUMBER	BOOK	SECTION
BUZ347	SC13	PM
BUZ348	SC13	PM
BUZ349	SC13	PM
BUZ350	SC13	PM
BUZ351	SC13	PM
BUZ355	SC13	PM
BUZ356	SC13	PM
BUZ357	SC13	PM
BUZ358	SC13	PM
BUZ384	SC13	PM
BUZ385	SC13	PM
BY228	SC01	R
BY229*	SC02	R
BY229F*	SC02	R
BY249*	SC02	R
BY249F*	SC02	R
BY260*	SC02	R
BY328	SC01	SD
BY329*	SC02	R
BY359*	SC02	R
BY359F	SC02	R
BY438	SC01	R
BY448	SC01	R
BY458	SC01	R
BY505	SC01	R
BY509	SC01	R
BY527	SC01	R
BY584	SC01	R
BY588	SC01	R
BY609	SC01	R
BY610	SC01	R
BY614	SC01	R
BY619	SC01	R
BY620	SC01	R
BY627	SC01	R
BY705	SC01	R
BY706	SC01	R
BY707	SC01	R
BY708	SC01	R
BY709	SC01	R

TYPE NUMBER	BOOK	SECTION
BY710	SC01	R
BY711	SC01	R
BY712	SC01	R
BY713	SC01	R
BY714	SC01	R
BY715	SC01	R
BY716	SC01	R
BY717	SC01	R
BY718	SC01	R
BY719	SC01	R
BY720	SC01	R
BY721	SC01	R
BY722	SC01	R
BY723	SC01	R
BY724	SC01	R
BYD11*	SC01	R
BYD13*	SC01	R
BYD14*	SC01	R
BYD17*	SC01/10	R/Mm
BYD31*	SC01	R
BYD33*	SC01	R
BYD34*	SC01	R
BYD37*	SC01/10	R/Mm
BYD73*	SC01	R
BYD74*	SC01	R
BYD77*	SC01	R
BYM26*	SC01	R
BYM36*	SC01	R
BYM56*	SC01	R
BYP20*	SC02	R
BYP21*	SC02	R
BYP22*	SC02	R
BYQ27*	SC01	R
BYQ28*	SC02	R
BYQ28F*	SC02	R
BYR28*	SC02	R
BYR29*	SC02	R
BYR29F*	SC02	R
BYR30*	SC02	R
BYR34*	SC02	R

TYPE NUMBER	BOOK	SECTION
BYR79*	SC02	R
BYT28*	SC02	R
BYT79*	SC02	R
BYT23OPIV	SC02	R
BYV10*	SC01	R
BYV24*	SC02	R
BYV26*	SC01	R
BYV27*	SC01	R
BYV28*	SC01	R
BYV29*	SC02	R
BYV29F*	SC02	R
BYV30*	SC02	R
BYV31*	SC02	R
BYV32*	SC02	R
BYV32F*	SC02	R
BYV34*	SC02	R
BYV36*	SC01	R
BYV42*	SC02	R
BYV44*	SC02	R
BYV54V	SC02	R
BYV72*	SC02	R
BYV72F*	SC02	R
BYV74*	SC02	R
BYV74F*	SC02	R
BYV79*	SC02	R
BYV92*	SC02	R
BYV95A	SC01	R
BYV95B	SC01	R
BYV95C	SC01	R
BYV96D	SC01	R
BYV96E	SC01	R
BYV118*	SC02	R
BYV118F*	SC02	R
BYV120*	SC02	R
BYV121*	SC02	R
BYV133*	SC02	R
BYV133F*	SC02	R
BYV143*	SC02	R
BYV143F*	SC02	R
BYW25*	SC02	R

TYPE NUMBER	BOOK	SECTION
BYW29*	SC02	R
BYW29F*	SC02	R
BYW30*	SC02	R
BYW31*	SC02	R
BYW54	SC01	R
BYW55	SC01	R
BYW56	SC01	R
BYW92*	SC02	R
BYW93*	SC02	R
BYW95A	SC01	R
BYW95B	SC01	R
BYW95C	SC01	R
BYW96D	SC01	R
BYW96E	SC01	R
BYX10G	SC01	R
BYX25*	SC02	R
BYX30*	SC02	R
BYX38*	SC02	R
BYX39*	SC02	R
BYX42*	SC02	R
BYX46*	SC02	R
BYX52*	SC02	R
BYX56*	SC02	R
BYX90G	SC01	R
BYX96*	SC02	R
BYX97*	SC02	R
BYX98*	SC02	R
BYX99*	SC02	R
BZD23	SC01	Vrg
BZD27	SC01/10	Vrg/Mm
BZT03	SC01	Vrg
BZV10	SC01	Vrf
BZV11	SC01	Vrf
BZV12	SC01	Vrf
BZV13	SC01	Vrf
BZV14	SC01	Vrf
BZV37	SC01	Vrf
BZV49*	SC01/10	Vrg/Mm
BZV55*	SC10	Mm
BZV60	SC01	Vrg

TYPE NUMBER	BOOK	SECTION
BZV80	SC01/10	Vrf/Mm
BZV81	SC01/10	Vrf/Mm
BZV84	SC01/10	Vrf/Mm
BZV85*	SC01	Vrg
BZV86	SC01	SD
BZV87	SC01/10	Vrg/Mm
BZW03*	SC01	Vrg
BZW14	SC01	Vrg
BZW86*	SC02	TS
BZX55*	SC01	Vrg
BZX70*	SC02	Vrg
BZX75*	SC01	Vrg
BZX79*	SC01	Vrg
BZX84*	SC01/10	Vrg/Mm
BZY91*	SC02	Vrg
BZY93*	SC02	Vrg
CNG35	SC12	PhC
CNG36	SC12	PhC
CNG40	SC12	PhC
CNG82	SC12	PhC
CNG83	SC12	PhC
CNR36	SC12	PhC
CNS35	SC12	PhC
CNW82	SC12	PhC
CNW83	SC12	PhC
CNX21	SC12	PhC
CNX35	SC12	PhC
CNX35U	SC12	PhC
CNX36	SC12	PhC
CNX36U	SC12	PhC
CNX38	SC12	PhC
CNX38U	SC12	PhC
CNX39	SC12	PhC
CNX39U	SC12	PhC
CNX48	SC12	PhC
CNX48U	SC12	PhC
CNX62	SC12	PhC
CNX62A	SC12	PhC
CNX71	SC12	PhC
CNX72A	SC12	PhC

TYPE NUMBER	BOOK	SECTION
CNX82A	SC12	PhC
CNX83A	SC12	PhC
CNY17-1	SC12	PhC
CNY17-2	SC12	PhC
CNY17-3	SC12	PhC
CNY17-4	SC12	PhC
CQW58A	S8a	I
CQW89A	S8a	I
CQW89B	S8a	I
CQY58A	S8a	I
CQY89A	S8a	I
CQY89F	S8a	I
ESM3045A(V)	SC06	SP
ESM3045D(V)	SC06	SP
ESM4045A(V)	SC06	SP
ESM4045D(V)	SC06	SP
ESM5045D(V)	SC06	SP
ESM6045A(V)	SC06	SP
ESM6045D(V)	SC06	SP
Fresnel-lens	SC12	A
H11A1	SC12	PhC
H11A2	SC12	PhC
H11A3	SC12	PhC
H11A4	SC12	PhC
H11A5	SC12	PhC
H11B1	SC12	PhC
H11B2	SC12	PhC
H11B3	SC12	PhC
H11B255	SC12	PhC
J108	SC07	FET
J109	SC07	FET
J110	SC07	FET
J111	SC07	FET
J112	SC07	FET
J113	SC07	FET
J174	SC07	FET
J175	SC07	FET
J176	SC07	FET
J177	SC07	FET
JA100	SC04	Sm

TYPE NUMBER	BOOK	SECTION
JA101	SC04	Sm
JC327	SC04	Sm
JC327A	SC04	Sm
JC328	SC04	Sm
JC337	SC04	Sm
JC337A	SC04	Sm
JC338	SC04	Sm
JC500	SC04	Sm
JC501	SC04	Sm
JC546	SC04	Sm
JC547	SC04	Sm
JC550	SC04	Sm
JC556	SC04	Sm
JC557	SC04	Sm
JC558	SC04	Sm
JC559	SC04	Sm
JC560	SC04	Sm
JF494	SC04	Sm
KGZ10	SC17	SEN
KGZ20	SC17	SEN
KGZ21	SC17	SEN
KMZ10A	SC17	SEN
KMZ10A1	SC17	SEN
KMZ10B	SC17	SEN
KMZ10C	SC17	SEN
KP100A	SC17	SEN
KP100A1	SC17	SEN
KP101A	SC17	SEN
KP130AE	SC17	SEN
KP131AE	SC17	SEN
KPZ20G	SC17	SEN
KPZ21G	SC17	SEN
KPZ21GE	SC17	SEN
KRX10	SC17	SEN
KRX11	SC17	SEN
KTY81-100*	SC17	SEN
KTY81-200*	SC17	SEN
KTY83-100*	SC17	SEN
KTY84-100*	SC17	SEN
KTY85-100*	SC10/17	SEN

TYPE NUMBER	BOOK	SECTION
KTY86-205	SC17	SEN
KTY87-205	SC17	SEN
LAE4001R	SC15	M
LAE4002S	SC15	M
LAE6000Q	SC15	M
LBE2003S	SC15	M
LBE2009S	SC15	M
LCE2003S	SC15	M
LCE2009S	SC15	M
LJE42002T	SC15	M
LKE21004R	SC15	M
LKE21015T	SC15	M
LKE21050T	SC15	M
LTE21009R	SC15	M
LTE21015R	SC15	M
LTE21025R	SC15	M
LTE4002S	SC15	M
LTE42005S	SC15	M
LTE42008R	SC15	M
LTE42012R	SC15	M
LUE2003S	SC15	M
LUE2009S	SC15	M
LV172E50R	SC15	M
LV2024E45R	SC15	M
LV2327E40R	SC15	M
LV2931E50S	SC15	M
LVE21050R	SC15	M
LWE2015R	SC15	M
LWE2025R	SC15	M
LZ1418E100R	SC15	M
LZE18100R	SC15	M
MCA230	SC12	PhC
MCA231	SC12	PhC
MCA255	SC12	PhC
MCT2	SC12	PhC
MCT26	SC12	PhC
MJE13004	SC06	SP
MJE13005	SC06	SP
MJE13006	SC06	SP
MJE13007	SC06	SP

TYPE NUMBER	BOOK	SECTION
MJE13008	SC06	SP
MJE13009	SC06	SP
MPS3702	SC04	Sm
MPS3703	SC04	Sm
MPS3704	SC04	Sm
MPS3705	SC04	Sm
MPS3706	SC04	Sm
MPS3904	SC04	Sm
MPS3906	SC04	Sm
MPS6513	SC04	Sm
MPS6514	SC04	Sm
MPS6515	SC04	Sm
MPS6517	SC04	Sm
MPS6518	SC04	Sm
MPS6519	SC04	Sm
MPS6520	SC04	Sm
MPS6521	SC04	Sm
MPS6522	SC04	Sm
MPS6523	SC04	Sm
MPS6531	SC04	Sm
MPS6532	SC04	Sm
MPS6534	SC04	Sm
MPS6535	SC04	Sm
MPSA05	SC04	Sm
MPSA06	SC04	Sm
MPSA13	SC04	Sm
MPSA14	SC04	Sm
MPSA25	SC04	Sm
MPSA26	SC04	Sm
MPSA27	SC04	Sm
MPSA42	SC04	Sm
MPSA43	SC04	Sm
MPSA55	SC04	Sm
MPSA56	SC04	Sm
MPSA63	SC04	Sm
MPSA64	SC04	Sm
MPSA75	SC04	Sm
MPSA76	SC04	Sm
MPSA77	SC04	Sm
MPSA92	SC04	Sm

TYPE NUMBER	BOOK	SECTION
MPSA93	SC04	Sm
MRB11175Y	SC15	M
MRB11350Y	SC15	M
MSB11900Y	SC15	M
MX0912B250Y	SC15	M
MX0912B350Y	SC15	M
MZ0912B50Y	SC15	M
MZ0912B100Y	SC15	M
OM200/S2	SC17	SEN
OM286	SC17	SEN
OM286M	SC17	SEN
OM287	SC17	SEN
OM287M	SC17	SEN
OM320	SC14	WBM
OM321	SC14	WBM
OM322	SC14	WBM
OM323	SC14	WBM
OM323A	SC14	WBM
OM335	SC14	WBM
OM336	SC14	WBM
OM337	SC14	WBM
OM337A	SC14	WBM
OM339	SC14	WBM
OM345	SC14	WBM
OM350	SC14	WBM
OM360	SC14	WBM
OM361	SC14	WBM
OM370	SC14	WBM
OM386B	SC17	SEN
OM386M	SC17	SEN
OM387B	SC17	SEN
OM387M	SC17	SEN
OM388B	SC17	SEN
OM389B	SC17	SEN
OM390	SC17	SEN
OM391	SC17	SEN
OM931	SC05	P
OM961	SC05	P
OM2860	SC17	SEN
OM2870	SC17	SEN

TYPE NUMBER	BOOK	SECTION
OSB/M/S9115*	SC02	St
OSB/M/S9215*	SC02	St
OSB/M/S9415*	SC02	St
OSM9510-12	SC02	St
PBYR635/40/45CT	SC02	R
PBYR735/40/45	SC02	R
PBYR735/40/45F	SC02	R
PBYR1035/40/45	SC02	R
PBYR1035/40/45F	SC02	R
PBYR1535/40/45CT	SC02	R
PBYR1535/40/45CTF	SC02	R
PBYR1635/40/45	SC02	R
PBYR1635/40/45F	SC02	R
PBYR2035/40/45CT	SC02	R
PBYR2035/40/45CTF	SC02	R
PBYR2535/40/45CT	SC02	R
PBYR2535/40/45CTF	SC02	R
PBYR3035/40/45PT	SC02	R
PBYR12035/40/45TV	SC02	R
PBYR16035/40/45TV	SC02	R
PBYR30035/40/45CT	SC02	R
PBYR40035/40/45CT	SC02	R
PH2222/A	SC04	Sm
PH2369	SC04	Sm
PH2907	SC04	Sm
PH2907A	SC04	Sm
PH5415	SC04	Sm
PH5416	SC04	Sm
PH6659	SC07	FET
PH6660	SC07	FET
PH6661	SC07	FET
PH13002	SC06	SP
PH13003	SC06	SP
PKB12005U	SC15	M
PKB20010U	SC15	M
PMBD914	SC01/10	SD/Mm
PMBD2835	SC01	SD
PMBD2836	SC01	SD
PMBD2837	SC01	SD
PMBD2838	SC01	SD

TYPE NUMBER	BOOK	SECTION
PMBD6050	SC01/10	SD/Mm
PMBD6100	SC01	SD
PMBD7000	SC01/10	SD/Mm
PMBF107	SC07	FET
PMBF170	SC07/10	FET/Mm
PMBF4391	SC07/10	FET/Mm
PMBF4392	SC07/10	FET/Mm
PMBF4393	SC07/10	FET/Mm
PMBFJ108	SC07/10	FET/Mm
PMBFJ109	SC07/10	FET/Mm
PMBJF110	SC07/10	FET/Mm
PMBFJ111	SC07/10	FET/Mm
PMBFJ112	SC07/10	FET/Mm
PMBJF113	SC07/10	FET/Mm
PMBFJ174	SC07/10	FET/Mm
PMBJF175	SC07/10	FET/Mm
PMBJF176	SC07/10	FET/Mm
PMBJF177	SC07/10	FET/Mm
PMBT2222	SC10	Mm
PMBT2222A	SC10	Mm
PMBT2369	SC10	Mm
PMBT2907	SC10	Mm
PMBT2907A	SC10	Mm
PMBT3904	SC10	Mm
PMBT3906	SC10	Mm
PMBT4401	SC10	Mm
PMBT4403	SC10	Mm
PMBT5088	SC10	Mm
PMBT5401	SC10	Mm
PMBT5550	SC10	Mm
PMBT5551	SC10	Mm
PMBT6428	SC10	Mm
PMBT6429	SC10	Mm
PMBTA05	SC10	Mm
PMBTA06	SC10	Mm
PMBTA13	SC10	Mm
PMBTA14	SC10	Mm
PMBTA42	SC10	Mm
PMBTA43	SC10	Mm
PMBTA55	SC10	Mm

TYPE NUMBER	BOOK	SECTION
PMBTA56	SC10	Mm
PMBTA63	SC10	Mm
PMBTA64	SC10	Mm
PMBTA92	SC10	Mm
PMBTA93	SC10	Mm
PMBZ5226	SC01	SD
PMLL4148	SC01/10	SD/Mm
PMLL4150	SC01/10	SD/Mm
PMLL4151	SC01/10	SD/Mm
PMLL4153	SC01/10	SD/Mm
PMLL4446	SC01/10	SD/Mm
PMLL4448	SC01/10	SD/Mm
PMLL5225B to	SC01/10	SD/Mm
PMLL5267B	SC01/10	SD/Mm
PN2222	SC04	Sm
PN2222A	SC04	Sm
PN2369	SC04	Sm
PN2907	SC04	Sm
PN2907A	SC04	Sm
PN3439	SC04	Sm
PN3440	SC04	Sm
PN4391	SC07	FET
PN4392	SC07	FET
PN4393	SC07	FET
PN5415	SC04	Sm
PN5416	SC04	Sm
PO44	SC12	PhC
PO44A	SC12	PhC
PPC5001T	SC15	M
PQC5001T	SC15	M
PRL4001	SC01/10	SD/Mm
PRL4002	SC01/10	SD/Mm
PRL5817	SC01/10	SD/Mm
PRL5818	SC01/10	SD/Mm
PRL5819	SC01/10	SD/Mm
PTB23001X	SC15	M
PTB23003X	SC15	M
PTB23005X	SC15	M
PTB32001X	SC15	M
PTB32003X	SC15	M

TYPE NUMBER	BOOK	SECTION
PTB32005X	SC15	M
PTB42001X	SC15	M
PTB42002X	SC15	M
PTB42003X	SC15	M
PVB42004X	SC15	M
PXB16050U	SC15	M
PXT2222	SC10	Mm
PXT2222A	SC10	Mm
PXT2907	SC10	Mm
PXT2907A	SC10	Mm
PXT3904	SC10	Mm
PXT3906	SC10	Mm
PXT4401	SC10	Mm
PXT4403	SC10	Mm
PXTA14	SC10	Mm
PXTA27	SC10	Mm
PXTA64	SC10	Mm
PXTA77	SC10	Mm
PZ1418B15U	SC15	M
PZ1418B30U	SC15	M
PZ1721B12U	SC15	M
PZ1721B25U	SC15	M
PZ2024B10U	SC15	M
PZ2024B20U	SC15	M
PZ2327B15U	SC15	M
PZB16035U	SC15	M
PZB16040U	SC15	M
PZB27020U	SC15	M
PZFJ108	SC07	FET
PZFJ109	SC07	FET
PZFJ110	SC07	FET
PZT2222	SC10	Mm
PZT2222A	SC10	Mm
PZT2907	SC10	Mm
PZT2907A	SC10	Mm
PZT3904	SC10	Mm
PZT3906	SC10	Mm
PZTA05	SC10	Mm
PZTA06	SC10	Mm
PZTA13	SC10	Mm

TYPE NUMBER	BOOK	SECTION
PZTA14	SC10	Mm
PZTA42	SC10	Mm
PZTA43	SC10	Mm
PZTA55	SC10	Mm
PZTA56	SC10	Mm
PZTA63	SC10	Mm
PZTA64	SC10	Mm
PZTA92	SC10	Mm
PZTA93	SC10	Mm
RPW100	SC17	SEN
RPW101	SC17	SEN
RPW102	SC17	SEN
RPY98A	SC17	SEN
RPY98C	SC17	SEN
RPY98F	SC17	SEN
RPY98G	SC17	SEN
RPY98S	SC17	SEN
RPY99A	SC17	SEN
RPY99C	SC17	SEN
RPY99D	SC17	SEN
RPY99F	SC17	SEN
RPY99G	SC17	SEN
RPY99S	SC17	SEN
RPY99P/P5206	SC17	SEN
RPY100	SC17	SEN
RPY102	SC17	SEN
RPY104A	SC17	SEN
RPY104C	SC17	SEN
RPY104D	SC17	SEN
RPY104F	SC17	SEN
RPY104G	SC17	SEN
RPY104S	SC17	SEN
RPY105P/P5206	SC17	SEN
RPY107	SC17	SEN
RPY108P/P5211	SC17	SEN
RPY109	SC17	SEN
RPY109B/P2105	SC17	SEN
RPY222	SC17	SEN
RV3135B5X	SC15	M
RX1011B350Y	SC15	M



TYPE NUMBER	BOOK	SECTION
RX1214B150Y	SC15	M
RX1214B300Y	SC15	M
RX2731B90W	SC15	M
RX3034B70W	SC15	M
RXB12350Y	SC15	M
RZ1214B35Y	SC15	M
RZ1214B65Y	SC15	M
RZ2731B16W	SC15	M
RZ2731B32W	SC15	M
RZ2731B48W	SC15	M
RZ2731B60W	SC15	M
RZ3135B14W	SC15	M
RZ3135B28W	SC15	M
RZ3135B42W	SC15	M
RZ3135B50W	SC15	M
RZB12050Y	SC15	M
RZB12100Y	SC15	M
RZB12250Y	SC15	M
SL5500	SC12	PhC
SL5501	SC12	PhC
SL5504	SC12	PhC
SL5505S	SC12	PhC
SL5511	SC12	PhC
TIP29*	SC05	P
TIP30*	SC05	P
TIP31*	SC05	P
TIP32*	SC05	P
TIP33*	SC05	P
TIP34*	SC05	P
TIP41*	SC05	P
TIP42*	SC05	P
TIP47	SC06	P
TIP48	SC06	P
TIP49	SC06	P
TIP50	SC06	P
TIP110	SC05	P
TIP111	SC05	P
TIP112	SC05	P
TIP115	SC05	P
TIP116	SC05	P

TYPE NUMBER	BOOK	SECTION
TIP117	SC05	P
TIP120	SC05	P
TIP121	SC05	P
TIP122	SC05	P
TIP125	SC05	P
TIP126	SC05	P
TIP127	SC05	P
TIP130	SC05	P
TIP131	SC05	P
TIP132	SC05	P
TIP135	SC05	P
TIP136	SC05	P
TIP137	SC05	P
TIP140	SC05	P
TIP141	SC05	P
TIP142	SC05	P
TIP145	SC05	P
TIP146	SC05	P
TIP147	SC05	P
TIP2955	SC05	P
TIP2955T	SC05	P
TIP3055	SC05	P
TIP3055T	SC05	P
VN2406L	SC07	FET
VN2410L	SC07	FET
1N821	SC01	Vrf
1N821A	SC01	Vrf
1N823	SC01	Vrf
1N823A	SC01	Vrf
1N825	SC01	Vrf
1N825A	SC01	Vrf
1N827	SC01	Vrf
1N827A	SC01	Vrf
1N829	SC01	Vrf
1N829A	SC01	Vrf
1N914	SC01	SD
1N916	SC01	SD
1N4001D	SC01	R
1N4002D	SC01	R
1N4003D	SC01	R

TYPE NUMBER	BOOK	SECTION
1N4004D	SC01	R
1N4005D	SC01	R
1N4006D	SC01	R
1N4007D	SC01	R
1N4001G	SC01	R
1N4002G	SC01	R
1N4003G	SC01	R
1N4004G	SC01	R
1N4005G	SC01	R
1N4006G	SC01	R
1N4007G	SC01	R
1N4148	SC01	SD
1N4150	SC01	SD
1N4151	SC01	SD
1N4153	SC01	SD
1N4446	SC01	SD
1N4448	SC01	SD
1N4531	SC01	SD
1N4532	SC01	SD
1N4933	SC01	R
1N5059	SC01	R
1N5060	SC01	R
1N5061	SC01	R
1N5062	SC01	R
1N5225 to	SC01	R
1N5267B	SC01	R
2N918	SC14	WBT
2N930	SC04	Sm
2N1613	SC04	Sm
2N1711	SC04	Sm
2N1893	SC04	Sm
2N2219	SC04	Sm
2N2219A	SC04	Sm
2N2222	SC04	Sm
2N2222A	SC04	Sm
2N2297	SC04	Sm
2N2369	SC04	Sm
2N2369A	SC04	Sm
2N2483	SC04	Sm
2N2484	SC04	Sm

TYPE NUMBER	BOOK	SECTION
2N2646	SC04	Sm
2N2894A	SC04	Sm
2N2904	SC04	Sm
2N2904A	SC04	Sm
2N2905	SC04	Sm
2N2905A	SC04	Sm
2N2906	SC04	Sm
2N2906A	SC04	Sm
2N2907	SC04	Sm
2N2907A	SC04	Sm
2N3019	SC04	Sm
2N3020	SC04	Sm
2N3053	SC04	Sm
2N3375	SC08a	RFP
2N3439	SC04	Sm
2N3440	SC04	Sm
2N3553	SC08a	RFP
2N3632	SC08a	RFP
2N3819	SC07	FET
2N3820	SC07	FET
2N3822	SC07	FET
2N3823	SC07	FET
2N3866	SC08a	RFP
2N3904	SC04	Sm
2N3905	SC04	Sm
2N3906	SC04	Sm
2N3924	SC08a	RFP
2N3926	SC08a	RFP
2N3927	SC08a	RFP
2N3966	SC07	FET
2N4030	SC04	Sm
2N4031	SC04	Sm
2N4032	SC04	Sm
2N4033	SC04	Sm
2N4036	SC04	Sm
2N4091	SC07	FET
2N4092	SC07	FET
2N4093	SC07	FET
2N4123	SC04	Sm
2N4124	SC04	Sm

TYPE NUMBER	BOOK	SECTION
2N4125	SC04	Sm
2N4126	SC04	Sm
2N4220	SC07	FET
2N4220A	SC07	FET
2N4221	SC07	FET
2N4221A	SC07	FET
2N4222	SC07	FET
2N4222A	SC07	FET
2N4340	SC07	FET
2N4391	SC07	FET
2N4392	SC07	FET
2N4393	SC07	FET
2N4400	SC04	Sm
2N4401	SC04	Sm
2N4402	SC04	Sm
2N4403	SC04	Sm
2N4416	SC07	FET
2N4416A	SC07	FET
2N4427	SC08a	RFP
2N4856	SC07	FET
2N4857	SC07	FET
2N4858	SC07	FET
2N4859	SC07	FET
2N4860	SC07	FET
2N4861	SC07	FET
2N5064	SC03	Tri
2N5086	SC04	Sm
2N5087	SC04	Sm
2N5088	SC04	Sm
2N5116	SC07	FET
2N5400	SC04	Sm
2N5401	SC04	Sm
2N5415	SC04	Sm
2N5416	SC04	Sm
2N5460	SC07	FET
2N5461	SC07	FET
2N5462	SC07	FET
2N5484	SC07	FET
2N5485	SC07	FET
2N5486	SC07	FET

TYPE NUMBER	BOOK	SECTION
2N5550	SC04	Sm
2N5551	SC04	Sm
2N5680	SC04	Sm
2N6027	SC04	Sm
2N6028	SC04	Sm
2N6659	SC07	FET
2N6660	SC07	FET
2N6661	SC07	FET
2N7000	SC07	FET
2N7002	SC07	FET
2PA733	SC04	Sm
2PA1015	SC04	Sm
2PA1015L	SC04	Sm
2PC945	SC04	Sm
2PC1815	SC04	Sm
2PC1815L	SC04	Sm
4N25	SC12	PhC
4N25A	SC12	PhC
4N26	SC12	PhC
4N27	SC12	PhC
4N28	SC12	PhC
4N29	SC12	PhC
4N30	SC12	PhC
4N31	SC12	PhC
4N32	SC12	PhC
4N33	SC12	PhC
4N35	SC12	PhC
4N36	SC12	PhC
4N37	SC12	PhC
4N38	SC12	PhC
4N38A	SC12	PhC
4N46	SC12	PhC
6N135	SC12	PhC
6N136	SC12	PhC
56201d	SC06	A
56201j	SC06	A
56245	SC04/14	A
56246	SC04/14	A
56261a	SC06	A
56264	SC03	A

TYPE NUMBER	BOOK	SECTION
56264a	SC02/03	A
56264b	SC02/03	A
56295	SC03	A
56295a	SC02/03	A
56295b	SC02/03	A
56295c	SC02/03	A
56326	SC06	A
56339	SC06	A
56352	SC06	A
56353	SC06/03	A
56354	SC06/03	A
56359b	SC02/03	A
56359c	SC02/03	A
56359d	SC02/03	A
56360a	SC02/03	A
56363	SC02/03	A
56364	SC02/03	A
56367	SC02/03	A
56368b	SC02/03	A
56368c	SC02/03	A
56369	SC02/03	A
56378	SC02/03	A
56379	SC02/03	A
56387a	SC06	A
56387b	SC06	A
56397	SC01	A



NOTES

**DATA HANDBOOK SYSTEM**

# DATA HANDBOOK SYSTEM

Our Data Handbook System comprises more than 60 books with specifications on electronic components, subassemblies and materials. It is made up of seven series of handbooks:

INTEGRATED CIRCUITS

DISCRETE SEMICONDUCTORS

DISPLAY COMPONENTS

PASSIVE COMPONENTS\*

PROFESSIONAL COMPONENTS\*\*

MAGNETIC PRODUCTS\*

LIQUID CRYSTAL DISPLAYS

The contents of each series are listed on pages iii to ix.

The data handbooks contain all pertinent data available at the time of publication, and each is revised and reissued periodically.

Where application is given it is advisory and does not form part of the product specification.

Condensed data on the preferred products of Philips Components is given in our Preferred Type Range catalogue (issued annually).

Information on current Data Handbooks and how to obtain a subscription for future issues is available from any of the Organizations listed on the back cover.

Product specialists are at your service and enquiries will be answered promptly.

\* Will replace the Components and materials (green) series of handbooks.

\*\* Will replace the Electron tubes (blue) series of handbooks.



# INTEGRATED CIRCUITS

This series of handbooks comprises:

code	handbook title
IC01	<b>Radio, audio and associated systems</b> Bipolar, MOS
IC02a/b	<b>Video and associated systems</b> Bipolar, MOS
IC03	<b>ICs for Telecom ;</b> Subscriber sets, Cordless Telephones, Mobile/Cellular, Radio Pagers
IC04	<b>HE4000B logic family</b> CMOS
IC05	<b>Advanced Low-power Schottky (ALS) Logic Series</b>
IC06	<b>High-speed CMOS; 74HC/HCT/HCU</b> Logic family
IC07	<b>Advanced CMOS logic (ACL)</b>
Supplement to IC07	<b>Advanced CMOS logic (ACL)</b>
IC08	<b>10/100K ECL Logic/Memory/PLD</b>
IC09	<b>TTL logic series</b>
IC10	<b>Memories</b> MOS, TTL, ECL
IC11	<b>Linear Products</b>
IC12	<b>I<sup>2</sup>C-bus compatible ICs</b>
IC13	<b>Programmable Logic Devices (PLD)</b>
IC14	<b>Microcontrollers</b> NMOS, CMOS
IC15	<b>FAST TTL logic series</b>
Supplement to IC15	<b>FAST TTL logic series</b>
IC16	<b>CMOS integrated circuits for clocks and watches</b>
IC17	<b>ICs for Telecom ;</b> ISDN
IC18	<b>Microprocessors and peripherals</b>
IC19	<b>Data communication products</b>
IC20	<b>8051-based 8-bit microcontrollers</b>
IC23	<b>Advanced BiCMOS interface logic</b>

## DISCRETE SEMICONDUCTORS

This series of data handbooks comprises:

current code	new code	handbook title
S1	SC01	Diodes High-voltage tripler units
S2a	SC02	Power diodes
S2b	SC03	Thyristors and triacs
S3	SC04	Small-signal transistors
S4a	SC05	Low-frequency power transistors and hybrid IC power modules
S4b	SC06	High-voltage and switching power transistors
S5	SC07	Small-signal field-effect transistors
S6	SC08a	RF power bipolar transistors
	SC08b	RF power MOS transistors
	SC09	RF power modules
S7	SC10	Surface mounted semiconductors
S8b	SC12	Optocouplers
S9	SC13	PowerMOS transistors
S10	SC14	Wideband transistors and wideband hybrid IC modules
S11	SC15	Microwave transistors
S13	SC17	Semiconductor sensors

## DISPLAY COMPONENTS

This series of data handbooks comprises:

code      handbook title

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- DC01    Colour display components**  
Colour TV Picture Tubes and Assemblies  
Colour Monitor Tube Assemblies
- DC02    Monochrome monitor tubes and deflection units**
- DC03    Television tuners, coaxial aerial input assemblies**
- DC04    Loudspeakers**
- DC05    Flyback transformers, mains transformers and  
general-purpose FXC assemblies**

## PASSIVE COMPONENTS

This series of data handbooks comprises:

current code	new code	handbook title
C14	PA01	Electrolytic capacitors; solid and non-solid
C11	PA02	Varistors, thermistors and sensors
C12	PA03	Potentiometers and switches
C7	PA04	Variable capacitors
C22	PA05*	Film capacitors
C15	PA06	Ceramic capacitors
C9	PA07*	Piezoelectric quartz devices
C13	PA08	Fixed resistors

\* Not yet issued with the new code in this series of handbooks.

## PROFESSIONAL COMPONENTS

This series of data handbooks comprises:

current code	new code	handbook title
T3	PC01	High-power klystrons and accessories
T5	PC02*	Cathode-ray tubes
T6	PC03*	Geiger-Müller tubes
T9	PC04	Photo multipliers
T10	PC05	Plumbicon camera tubes and accessories
T11	PC06	Circulators and Isolators
T12	PC07	Vidicon and Newvicon camera tubes and deflection units
T13	PC08	Image intensifiers
T15	PC09	Dry-reed switches
	PC11	Solid state image sensors and peripherals integrated circuits
T9	PC12*	Electron multipliers

\* Not yet issued with the new code in this series of handbooks.

## MAGNETIC PRODUCTS

This series of data handbooks comprises:

current code	new code	handbook title
C4 } C5 }	MA01	Soft Ferrites
C16	MA02*	Permanent magnet materials
C19	MA03*	Piezoelectric ceramics

\* Not yet issued with the new code in this series of handbooks.

## LIQUID CRYSTAL DISPLAYS

current code	new code	handbook title
<b>S14</b>	<b>LCD01</b>	<b>Liquid Crystal Displays and driver ICs for LCDs</b>

- Argentina:** PHILIPS ARGENTINA S.A., Div. Philips Components, Vedia 3892, 1430 BUENOS AIRES, Tel. (01)541-4261.
- Australia:** PHILIPS COMPONENTS PTY Ltd, 11 Waltham Street, ARTARMON, N.S.W. 2064, Tel. (02)4393322.
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